

AIR FORCE TO 33B-1-1 ARMY TM 1-1500-335-23 NAVY (NAVAIR) 01-1A-16-1

TECHNICAL MANUAL

NONDESTRUCTIVE INSPECTION METHODS, BASIC THEORY

PREPARED BY AFSC COMMODITY TEAM

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INTRODUCTION

1 PURPOSE.

Nondestructive Inspection (NDI) is the inspection of a structure or component in any manner that will not impair its future usefulness. The purpose of the inspection may be to detect flaws, measure geometric characteristics, determine material structure or composition, or it may characterize physical, electrical, or thermal properties without causing any changes in the part. The seven standard NDI disciplines include:

- Liquid Penetrant
- Magnetic Particle
- Eddy Current
- Ultrasonic
- Radiography
- Thermography
- Shearography

Visual inspections are not considered tasks or functions for NDI technicians under the scope of this manual; however, visual inspections are often called out in system specific NDI tech data.

NOTE

TO 33B-1-1 SHALL NOT be used as a stand-alone inspection manual. Any reference to perform an inspection "in accordance with TO 33B-1-1," or any American Society for Testing and Materials (ASTM) standard or Military Standard (MIL-STD) without sufficient supplemental information SHALL be challenged by submitting an AFTO Form 22 to the responsible System Program Office (SPO) to be placed in the proper technical manual. Sufficient supplemental information consists of a complete inspection procedure as stated in Paragraph 2: Scope. TO 33B-1-2 *General NDI Procedures and Process Controls* can be used as a stand-alone inspection document when no other inspection guidance exists and test part geometry, material, coating, and surface finish permits. However, it remains a priority to develop and publish specific inspection procedures for test parts that require routine or recurring inspections.

2 SCOPE.

This publication contains the concepts, process controls, and theory of NDI methods and SHALL be used as a guide in de-

velopment of NDI procedures and manuals. Guidance for development of NDI procedures is contained in MIL-DTL-87929D, Appendix F. NDI procedures SHALL be detailed step-by-step instructions with illustrations so a qualified NDI technician can perform the required inspection. In addition, this manual provides guidance in safety guidelines of these NDI methods. This manual is intended for use by Air Force, Navy Air, Army and DoD contractors when specified. When the guidelines of this manual conflict with details in a depot local processing directive, or a weapon system specific directive, the depot local processing directive or weapon system specific directive SHALL take precedence.

3 FORMAT OF PROCEDURES.

An individual qualified and certified to Level 3 in accordance with NAS 410 in the inspection method being used SHALL approve all written procedures. All on and off-equipment maintenance NDI manuals (e.g. -9, -36, etc.) SHALL be written to adopt the requirements of MIL-DTL-87929D and MIL-PRF-83495 as applicable. MIL-DTL-87929D directs that procedures for commodity items and support equipment contained in or on the weapon system SHALL be included in the system specific manual. To clarify this, if the part is inspected on the aircraft or removed for inspection without further disassembly, the procedure SHALL be included in the specific aircraft NDI manual; however, if part requires further disassembly, the procedures SHALL be located in the commodity component's overhaul or maintenance manual. For specific information on the operation, maintenance, or inspection of a particular piece of NDI equipment or a weapons system, consult the appropriate technical manual. References to TO 33B-1-1 or ASTM standards alone SHALL NOT be used since they do not provide any inspection/part/material details.

4 KNOWLEDGE OF NDI.

Nondestructive inspection methods allow trained and experienced technicians the capability to detect flaws with a high degree of accuracy and reliability. Each method has inherent limitations that must be recognized by technicians and engineering alike. A noted defect indication resulting from one method should rarely be considered conclusive and should be confirmed by another method when possible. While inspection instructions help ensure proper inspection application, they cannot replace the value of proper training and experience. A thorough knowledge of NDI theory and practical application is required.

5 TRI-SERVICE MANUAL.

33B-1-1 is a Tri-service manual and some information may be directed at one branch of service and not the others. References to Technical Order (TO), Technical Manual (TM), and Naval Air Regulation (NAVAIR) publications all have the same meaning. All inquiries regarding the technical content should be addressed to the Air Force NDI Office which is the Office of Primary Responsibility (OPR) for this publication at AFLCMC/EZPT-NDIO, aflcmc-ezpt-ndio@us.af.mil; DSN 339-4931. To suggest changes to this publication, AF users SHALL use an AFTO Form 22; Army users SHALL send comments and suggested changes through the AMCOM Publications System: <https://amcom2028.redstone.army.mil> or by fax on DA Form 2028 to DSN 788-6546 or Commercial (256) 842-6546; and Navy and Marine Corps personnel SHALL identify deficiencies and/or recommend changes and correc-

tions via the on-line Joint Deficiency Reporting System (JDRS) at <https://jdrs.mil>. First time Navy users must register. Select SITE ACCESS and then "New User Registration". Once registered, log in, and under TOOLKIT, select "Initiate DR"; then select TPDR. For detailed instructions, find *TPDR Submissions Handbook NAVAIR* by selecting *Handbooks* under the HELP menu.

6 IMPROVEMENT REPORTS.

Recommendations for improvements to prescribed requirements and procedures will be submitted by AFTO Form 22, Technical Order System Publication Improvement Report, in accordance with TO 00-5-1. Completed forms will be forwarded to AFLCMC/LZPTP.

SAFETY SUMMARY

1 GENERAL SAFETY INSTRUCTIONS.

The following are general safety precautions and instructions individuals must understand and apply during many phases of operation and maintenance to ensure personal safety, health, and the protection of Air Force property. Portions of this may be repeated elsewhere in this publication for emphasis. Additional safety precautions are contained in AFI 91-203; Navy OPNAVINST 5100.23; and Army AR 385-10.

2 SHALL, SHOULD, MAY, AND WILL.

Use the word "SHALL" whenever a manual expresses a provision that is binding. Use "SHOULD" and "MAY" whenever it is necessary to express non-mandatory provisions. "WILL" may be used to express a declaration purpose. It may be necessary to use "WILL" in cases where simple futurity is required (e.g. "Power for the meter WILL be supplied by the ship").

3 WARNINGS, CAUTIONS, AND NOTES.

WARNINGS and CAUTIONS are used in this manual to highlight operating or maintenance procedures, practices, conditions, or statements considered essential to protection of personnel (WARNING) or equipment (CAUTION). WARNINGS and CAUTIONS immediately precede the step or procedure to which they apply. WARNINGS and CAUTIONS consist of four parts: a heading (WARNING, CAUTION, or Icon); a statement of the hazard, minimum precautions, and possible result if disregarded. NOTES may precede or follow the step or procedure, depending upon the information to be highlighted. The heading used and the definitions are as follows:

WARNING

This highlights an essential operating or maintenance procedure, practice, condition statement, etc., which if not strictly observed, could result in injury to, or death of, personnel and/or long term health hazards.

CAUTION

This highlights an essential operating or maintenance procedure, practice, condition, statement, etc., which if not strictly observed, could result in damage to, or destruction of, equipment and/or loss of mission effectiveness.

NOTE

This highlights an essential operating or maintenance procedure, condition, or statement.

4 HAZARDOUS MATERIALS WARNINGS.

Consult the Safety Data Sheet (SDS) for specific information on hazards, effects, and protective equipment requirements. If you do not have a SDS for the material involved, contact your supervisor, Base Safety Office, or Bioenvironmental Engineering.

5 SAFETY PRECAUTIONS.

The following safety precautions SHALL be observed while performing procedures in this manual:

- **CAUTION AROUND LIVE CIRCUITS.** Operating personnel must observe safety regulations at all times. Do not replace components or make adjustments inside equipment while the electrical supply is turned on. Under certain conditions, such as residual charges on capacitors, danger may exist even when the power control is in the off position. To avoid injuries, always disconnect power, discharge and ground circuit before touching it. Adhere to all lockout/tag-out requirements.
- **DO NOT SERVICE ALONE.** Under no circumstances should any persons perform maintenance on the equipment except in the presence of someone who is capable of rendering aid.
- **RESUSCITATION.** Personnel working with or near high voltage SHALL be familiar with modern methods of resuscitation. Such information may be obtained from the Director of Base Medical Services.
- **FINGER RINGS AND OTHER JEWELRY.** Remove rings, watches, and other metallic objects during all maintenance activity that may cause shock, burn, or other hazards. Snagged finger rings have caused many serious injuries.
- **PERSONAL PROTECTIVE EQUIPMENT (PPE).** The work center supervisor SHALL contact the Installation Ground Safety and Bioenvironmental Engineering Offices for a list of approved protective clothing/equipment (gloves, apron, eye protection, etc.) for the chemicals, materials, and tools being

used. The Bioenvironmental Engineering Office SHALL approve all protective clothing/equipment for the chemicals, materials, and processes in writing. PPE SHALL be worn when and where directed to do so by the Bioenvironmental Engineering Office.

- **COMPRESSED AIR.** If using compressed air for cleaning electrical equipment, limit air pressure to less than 30 psi unless a lower pressure is required by TO, manufacturer's data, or local procedures. Effective chip guarding (nozzle discharge tip is a diffuser type) and PPE will be used. Lab supervisors SHALL contact the local Safety Office for guidance.
- **PRECAUTIONS WITH EYEWEAR.** Personnel who wear contact lens shall identify this to their supervisor and refer to the appropriate material safety data sheets (SDS) for possible hazards involved in wearing contact lens around chemicals and abide by the guidance for that chemical. Photochromatic lenses (lenses that darken when exposed to sunlight or ultraviolet light), sunglasses, and colored contacts reduce the visibility of fluorescent indications. This leads to the possibility of faint indications not being seen by the inspector. Therefore, glasses with photochromatic lenses, sunglasses or colored contact lenses SHALL NOT be worn when performing fluorescent penetrant or fluorescent magnetic particle inspections.
- **SAFETY WITH UV-A (BLACK LIGHT) LAMPS.** UV-A bulbs SHALL NOT be operated without proper filters. Cracked, chipped, or ill-fitting filters SHALL be replaced before using the lamp. Unfiltered ultraviolet radiation can be harmful to the eyes and skin. Prolonged direct exposure of hands to the filtered UV-A main beam may be harmful. Suitable gloves SHALL be worn when exposing hands to the main beam; UV-A filtering safety glasses, goggles, or face shields SHALL also be worn. A UV-A bulb (mercury vapor and high intensity discharge) heats the external surfaces of the lamp housing. The temperature of some operating bulbs reaches 750°F (399°C) or more during operation. The temperature is not high enough to be visually apparent, but it is high enough to cause severe burns with even momentary contact of exposed body surfaces. Extreme care SHALL be exercised to prevent contacting the housing with any part of the body. These temperatures are also above the ignition or flash point of fuel vapors. These vapors WILL burst into flames if they contact the bulb. UV-A lamps SHALL NOT be operated when flammable vapors are present unless they are specifically certified as intrinsically safe for such environments AND are approved by the local Safety and Bioenvironmental Engineer/Environmental Management offices.
- **SOLVENTS, CHEMICALS, AND OTHER TOXIC MATERIALS.** Solvents used may contain aromatic, aliphatic, or halogenated compounds. Many are high flammable, while others may decompose at elevated temperatures. Solvents SHALL be kept away from heat and open flames. Vapors also may be harmful to personnel, thus adequate ventilation SHALL be used. Contact with skin and eyes SHALL be avoided. Solvents SHALL NOT be ingested. Waste material disposal SHALL be according to applicable directives or as specified by local Bioenvironmental Engineering/Environmental Management Offices. Keep cleaners/chemicals in approved safety containers and maintain minimum quantities. Some cleaners/chemicals may have an adverse effect on skin, eyes, and respiratory tract. Observe manufacturer's WARNING labels; Safety Data Sheet (SDS) instructions for proper handling, storage, and disposal; and current safety directives. Use cleaners/chemicals only in authorized areas. Discard soiled cloths into approved safety cans. Consult local Bioenvironmental Engineering for specific protective equipment and ventilation requirements.
- **USE OF RESPIRATORS.** Dry developer particles are not toxic materials. However, like any solid foreign matter, they SHALL NOT be inhaled. Air cleaners, facemasks, or respirators may be required. Bioenvironmental Engineering SHALL be consulted if the process generates airborne particles.
- **EXPOSURE TO SF₆ GAS.** Exposure to excessive amounts of Sulphur Hexafluoride (SF₆) gas can cause asphyxiation by displacing oxygen in the air. Care SHALL be taken not to release large quantities of SF₆ gas into unvented work areas. The amount leaked into the air while performing normal X-ray tube repair does not create an asphyxiation hazard. When SF₆ is heated, it liberates hazardous fluorine gas into the air. This possibility of producing fluorine gas exists in most X-ray tube heads. Precautions SHALL be taken to guard against the inhalation of the gas released from X-ray tubes that have been energized.
- **IMPROPER CLEANING PROCEDURES.** Improper cleaning procedures/materials can cause severe damage to the material under inspection. Preparation of parts to include but not limited to paint removal and chemical etching SHALL be accomplished by maintenance personnel who are properly trained, highly skilled, and experienced in those particular specialties and are aware of the effects on the part/material due to the use of these chemicals and methods. TO 1-1-691 applies to the Air Force, T.M. 1-1500-344-23 applies for the Army; and N.A. 01-1A-509 applies for the Navy and Marine Corps. For Navy and Marine Corps, swab application (ONLY) of etchants SHALL only be performed by NDI per-

sonnel who have properly documented training. Immersion application of etchants SHALL be accomplished by maintenance personnel who have properly documented training.

- **PRECAUTIONS DURING RADIOGRAPHIC INSPECTIONS.** Exposure to excessive X or gamma radiation is harmful to personnel and especially an unborn fetus. All applicable safety precautions SHALL be complied with. While most X-ray equipment is designed to minimize the danger of exposure to direct or stray radiation, certain precautions SHALL be observed. Failure to comply with safety procedures may result in serious injury to personnel in the area. Coordinate all operational changes with the Radiation Safety Officer. Radiation protection requirements are discussed further in [Paragraph 6.8](#) of this manual. (NAVY ONLY: Radiation safety guidance is provided by NAVSEA S0420-AA-RAD-010.)
- **PRECAUTIONS DURING PENETRANT INSPECTIONS.** Penetrant inspection includes the use of UV-A lamps and exposure to flammable chemicals that may affect skin, eyes, and respiratory tract. Care SHALL be exercised when using hot UV-A lamps so as not to burn hands, arms, face, or other exposed body areas. Wear nitrile, neoprene, or other approved gloves and keep the insides of gloves clean when handling penetrant materials. When processing parts through chemicals in the stationary lines, appropriate (i.e. UV-A safety glasses) eyewear, rubber apron, and protective gloves SHALL be worn. During times of portable inspection, a minimum of protective gloves and eye protection SHALL be worn. Consult your local Bioenvironmental and Safety Offices for further guidance. Ensure the Bioenvironmental Office performs an adequate surface area exhaust ventilation evaluation at intervals required in AFI 48-145 or Army or Navy equivalent. When recommended by Bioenvironmental Engineering, an approved respirator SHALL be worn when working in areas where adequate ventilation cannot be practically provided. The use of visible dye penetrant is PROHIBITED on engine, aircraft, and missile parts except for those with specific engineering approval for each inspection.

- **PRECAUTIONS DURING MAGNETIC PARTICLE INSPECTIONS.** Magnetic particle inspection includes exposure to chemicals, ultraviolet light, and electrical current. Rubber insulating floor matting, rated for the voltage of the equipment being worked on, SHALL be used in front of magnetic particle units. Care SHALL be exercised when using hot UV-A lamps so as not to burn hands, arms, face, or other exposed body areas. Wear nitrile, neoprene, or other approved gloves and keep the insides of gloves clean when handling penetrant materials. When processing parts through chemicals in the stationary lines, appropriate (i.e. UV-A safety glasses) eyewear, rubber apron, and protective gloves SHALL be worn. During times of portable inspection, a minimum of protective gloves and eye protection SHALL be worn. Consult your local Bioenvironmental Engineering and Safety Offices for further guidance. Ensure the Bioenvironmental Engineering Office performs an adequate surface area exhaust ventilation evaluation at intervals required in AFI 48-145 or Army or Navy equivalent.

6 ACCESS TO SURFACES AND PART PREPARATION.

Access to aircraft surfaces (e.g. panel removal) requiring Non-destructive Inspection, SHALL be accomplished by maintenance personnel who have properly documented training and are highly experienced in those particular specialties. Improper cleaning procedures/materials can cause severe damage to the material under inspection. Preparation of parts to include, but not limited to, paint removal and chemical etching SHALL be accomplished by maintenance personnel who are properly trained, highly skilled, and experienced in those particular specialties and are aware of the effects on the part/material due to the use of these chemicals and methods. TO 1-1-691 applies for the Air Force, T.M. 1-1500-344-23 applies for the Army, and N.A. 01-1A-509 applies for the Navy and Marine Corps. For Navy and Marine Corps, swab application (ONLY) of etchants SHALL only be performed by NDI personnel who have properly documented training. Immersion application of etchants SHALL be accomplished by maintenance personnel who have properly documented training.

CHAPTER 1

NONDESTRUCTIVE INSPECTION METHODS, GENERAL INFORMATION

SECTION I NONDESTRUCTIVE INSPECTION (NDI) METHODS

1.1 WHY WE DO NONDESTRUCTIVE INSPECTION (NDI).

NOTE

(NAVY Only) Policy guidance in OPNAV Instruction 4790.2 SHALL take precedence over the policy contained within this manual.

1.1.1 Nondestructive Inspection Data. Nondestructive Inspection (NDI) data for aircraft, missiles, engines, and accessory items provides material condition information to the engineers and managers in the System Program Offices (SPO). The SPO uses this data to manage assets.

1.1.2 Structural Management Programs. Managing aircraft safety requires effective NDI processes and NDI data. Two specific programs include the Aircraft Structural Integrity Program (ASIP) and the Engine Structural Integrity Program (ENSIP).

1.1.2.1 Aircraft Structural Integrity Program (ASIP). ASIP is a program that determines the structural life of specific aircraft. MIL-HDBK-1530 addresses the requirements of the ASIP program. An aircraft manufacturer (Boeing Military Aerospace Company, Lockheed-Martin Aerospace Company, Northrop-Grumman, etc.) develops an aircraft specific ASIP master plan in accordance with MIL-HDBK-1530. This plan describes the mission, design requirements and operational assumptions, inspection areas, proposed inspection methods, and the critical crack criteria to assess the condition of aircraft. The Air Logistics Complexes (ALC) at Oklahoma City, OK, Ogden, UT, and Warner-Robins, GA, maintain a cadre of material and structural engineers that use NDI data to determine the safe operating conditions for aircraft. The original aircraft manufacturer also maintains a similar cadre of engineers. The combined efforts of the aircraft manufacturer and the ALC determine the conditions for safe operation of the aircraft, recommended inspection intervals, and the inspection requirements.

1.1.2.2 Engine Structural Integrity Program (ENSIP). ENSIP determines the structural lifetime of engine components. An engine manufacturer (Pratt-Whitney, General Electric, Rolls Royce, etc.) develops an ENSIP program for their specific engine. The manufacturers and the Oklahoma City Air Logistics Complex maintain a cadre of material and structural engineers to evaluate the engine structure. This program describes the design requirements and operational assumptions, inspection areas, proposed inspection methods, and damage detection capability criteria to assess the condition of the engine. Some damage is a combination of high temperature, erosion, corrosion, and fatigue damage. Critical engine inspections are performed both in the field and depots, with the more thorough or in-depth inspections being performed at depot level. All inspections are just as important to the safe operation of the engine and to provide information back to the engine managers and engineers.

1.1.3 Mechanisms for Using NDI Data. Here are some specific mechanisms used by the previous programs for assessing NDI data.

1.1.3.1 Durability and Damage Tolerance Assessment (DADTA). Durability Assessment is the ability of the aircraft to withstand normal operating conditions and still be operational. Damage Tolerance Assessment is the ability of the aircraft to remain operational after damage occurs. The combination of Durability and Damage Tolerance Assessment is used to predict the safe operating characteristics for the aircraft. DADTA analysis is taken from fatigue test articles, field reports, and flaw damage assumptions. DADTA engineers assume a certain flaw size in areas of the aircraft structure. They use computer models to predict the growth of these flaws to critical size. The time interval, under normal operating characteristics required to grow a crack from an assumed size to a critical size is approximately equal to two depot maintenance or inspection cycles. DADTA analysis often use crack sizes derived from Probability of Detection (POD) studies and field reports to determine what should be assumed as the initial flaw size. This means no matter what inspection is being used, the inspector should be ever vigilant to finding and characterizing any flaws they find because the data is used to manage the aircraft for safe operation.

1.1.3.2 Fracture Mechanics. Aircraft designers use a process to design aircraft structures called "Fracture Mechanics." Each material has a degree of fracture toughness or resistance to crack initiation. Each material has a degree of damage tolerance (durability) or the resistance to crack growth. The combined effect of fracture toughness and durability determines the use of the material in aircraft design. The designer uses the information on the material's characteristics to design a part that will indicate the presence of a crack or flaw long before the flaw causes a complete failure of the structure. NDI plays an important role in fracture mechanics. NDI is the detection function on which engineers rely. Engineers rely on NDI to identify cracks and flaws before they grow to sufficient size to cause component or system failure. Proper and accurate application of NDI finds the flaws before the part fails.

1.1.4 Tools for Gathering NDI Data.

1.1.4.1 Probability of Detection (POD) Studies. The 90% POD value is an estimate of the defect size an inspector can find 9 out of 10 times. The 95% confidence bound (also known as the 90/95 POD) provides information about the variability of the POD experiment (like the number of flawed and unflawed specimens used, and the distribution of cracks in the specimens). The 90% POD is used to assess their individual capabilities, or to compare the abilities of inspection systems or procedures. Risk Assessment Engineers can use the 95% Confidence Bounds (90/95 POD) to set initial and recurring inspections for a particular application. More information on performing POD assessments can be found in MIL-HDBK-1823, Nondestructive Evaluation System Reliability Assessment, available at <https://assist.daps.dla.mil/quicksearch>.

1.1.4.2 Analytical Condition Inspection (ACI). ACI inspections are required occasionally on certain areas of the aircraft. ACI inspections are added to normal routine inspections to determine if there are sites of damage not addressed under the ASIP, ENSIP, or other maintenance programs. When engineers have reason to believe there may be damage occurring to areas of the aircraft not normally inspected, they require special inspections. These inspections go beyond what is normally required in ASIP or Programmed Depot Maintenance (PDM) work. The results of an ACI may influence future ASIP and PDM inspections.

1.1.4.3 Human Factors. As technology advances, one factor we need to make sure we consider as we insert new technology is human factors. Human Factors is the application of how we see, hear, think and physically function to the design of inspection methods and processes. Both human capabilities and human limitations need to be taken into account for the design and selection of any inspection equipment. Human factors also need to be taken into consideration for facilities, procedures and training requirements. We know that certain environmental characteristics affect our ability to perceive certain events. Physical stress (e.g. reaching overhead), psychological tension (e.g. upcoming WAPS exams), attention demands (e.g. completing report forms), visual/audio distractions (e.g. ramp traffic/rivet guns), heavy workload (e.g. 12-hours shifts) and complex decision making processes (e.g. shear wave UT with multiple peaks rising and falling), are just some of the factors that affect human capabilities.

SECTION II PERSONNEL TRAINING/ QUALIFICATION/CERTIFICATION

1.2 PERSONNEL TRAINING/ QUALIFICATION/CERTIFICATION.

1.2.1 Training Introduction. All personnel require formal training, on-the-job training (OJT), and certification prior to performing nondestructive inspections. All military personnel SHALL be certified, in writing, in accordance with their military service directives. All civil service and contracted lab personnel SHALL be certified to NAS 410.

NOTE

Navy personnel training, qualification and certification is governed by COMNAVAIRFORINST 4790.2 and SHALL be in lieu of this SECTION.

1.2.2 Training Requirements.

1.2.2.1 Formal Training. Formal training SHALL be provided by an accredited institution approved by the responsible military agency for each branch of service. These facilities and instructors SHALL provide training in the basic theory and application of nondestructive inspection disciplines. Air Force and NAVAIR uniformed service members receive formal training at Naval Air Station, Pensacola, FL. Army uniformed service members receive formal training at 128th Aviation Brigade, Joint Base Langley-Eustis, VA.

- Air Force: the Air Education and Training Command (AETC) through the Utilization and Training Workshop, identifies and approves the instruction provided at the USAF NDI School at NAS Pensacola, FL. **For field civil service personnel requiring NAS 410 certification:** Formal training provided by other agencies SHALL receive accreditation and approval from the Air Force NDI Office (AFNDIO), AFLCMC/EZPT-NDIO, Tinker AFB, OK, prior to being accepted.”
- Army: personnel SHALL be trained in accordance with Department of the Army Pamphlet 611-21, to include alternate training sources as approved by TRADOC or the Program Manager, National Guard Bureau (NGB) NDT Program, Aviation Systems Branch. ARNG personnel SHALL comply with the requirements of NGR 750-410 Army National Guard Aviation Nondestructive Testing Program.

1.2.2.2 On-The-Job Training (OJT). Hands-on training for the practical application of NDI disciplines SHALL be provided by the work center and SHALL be provided by personnel qualified and certified as OJT trainers/certifiers for the inspection. All OJT SHALL be documented in accordance with AFI 36-2670, AFI 21-101, and/or other local directives.

NOTE

(Army Only) The minimum hours of OJT required prior to Task Specific Qualification (TSQ) evaluation SHALL NOT be less than 10% of the experience hours required for Level 1 in the appropriate method (i.e. 13 hours for each MT and PT, 40 hours for each UT and ET).

1.2.3 Certification Requirements.

1.2.3.1 Military Personnel. All military personnel SHALL be certified, in writing, in accordance with their military service directives.

1.2.3.1.1 Air Force. Air Force military personnel (Active Duty, Air National Guard, Reserves) SHALL be certified in accordance with procedures outlined in their Career Field Education and Training Plan (CFETP) for Air Force Specialty Code (AFSC) 2A7X2. Personnel in 5-level upgrade training (UGT) shall have four (4) months of documented and continual training for interpreting indication core tasks for Fluorescent Penetrant and Magnetic Particle and six (6) months for Eddy Current, Ultrasonic (including composite and bond testing) and Radiography inspection methods PRIOR to certification. Personnel in 7-level UGT shall have four (4) months of documented and continual training for weld certification tasks PRIOR to certification. Certification SHALL be conducted with developed evaluation tools (e.g., Third-Party Certification Plan) IAW AFI 36-2670.

NOTE

The certifier SHALL be a person other than the trainer and meet the requirements of AFI 36-2670.

1.2.3.1.2 **Army.** Army personnel successfully completing Military Occupational Specialty (MOS) 15D and Nondestructive Testing formal training either from 128th Aviation Brigade or NAS Pensacola, FL, SHALL require certification (i.e. documentation of Task Specific Qualification) prior to making accept/reject decisions on aviation assets. Active Duty and Reserve personnel SHALL receive TSQ evaluations from senior NDT qualified Unit personnel to assess proficiency. National Guard personnel SHALL be qualified/certified IAW NGR 750-410.

1.2.3.2 Civilian Personnel.

1.2.3.2.1 **Air Force.** The Air Force currently recognizes National Aerospace Standard (NAS) 410, Certification Qualification of Nondestructive Test Personnel, as the approved standard for qualification and certification. This standard establishes minimum training, experience, and examination requirements for personnel performing NDI in the aerospace manufacturing, service, maintenance, and overhaul industry. All Air Force Field civil service nondestructive inspection technicians SHALL be certified and qualified IAW Appendix A (exception: Technicians who hold a full-time civil service position matched with a military position in their ANG or AFRC unit will be certified IAW [Paragraph 1.2.3.1.1](#)). Depot civil service nondestructive inspection technicians are certified to NAS 410 in accordance with AFSCI 20-114, *Qualification of Nondestructive Inspection Personnel*. Contracted lab personnel (managed by private contractor or Civil Service) SHALL be certified by their employer in accordance with NAS 410. NAS 410 provides the minimum requirements for the qualification and certification of personnel conducting nondestructive testing. Compliance of contracted lab personnel SHALL be audited and validated by the Air Force NDI Office (AFLCMC/EZPT-NDIO), Tinker AFB, OK at any time deemed necessary by the Air Force to ensure certification of contracted NDI personnel is in compliance with the requirements of NAS 410. Additionally, the Air Force NDI Office shall review third-parties providing certification services to contractor operated, AF-owned NDI laboratories, to ensure compliance with NAS 410.

1.2.3.2.2 **Army.** DOD and non-DOD Civilian inspectors SHALL be certified IAW NAS 410.

1.2.4 Experience Hours Documentation.

1.2.4.1 Air Force.

1.2.4.1.1 All military NDI technicians should personally document their experience hours, and may use a form such as AF IMT 3126 or other documentation methods available on the AF NDI SharePoint (<https://usaf.dps.mil/teams/22399/SitePages/Home.aspx>) (see [Figure 1-1](#) for an example). Hours should be tracked by each method and technique for personal historical purposes. See [Appendix A](#), Paragraph A.7 for a list of common NDI methods and associated techniques. Technicians should ensure a certified trainer or supervisor signs and dates each form to indicate its accuracy.

NOTE

Only experience hour logs documenting methods and techniques performed by the technician shall be certified by the appropriate personnel. Alternate methods to determine experience hours (e.g., Experience hour calculator, memo with a guesstimate of hours, etc.) are not valid or authorized.

1.2.4.1.2 Experience hours must be actual performance of an NDI method conducted in the work environment resulting in the acquisition of knowledge and skill. NDI technician's presence in a eight hour shift must not be logged in as eight hours of NDI experience unless actual performance of NDI method was executed. Formal classroom training cannot be counted as NDI experience hours. Laboratory and on-the-job training can be counted as NDI experience hours.

1.2.4.2 **Army.** Active Duty and Reserve personnel SHALL document experience hours performing each method to substantiate Task Specific Qualification. National Guard technicians shall comply with NGR 750-410.

1.2.5 Physical Requirements.

1.2.5.1 **Near Vision Requirements.** All NDI personnel SHALL receive a near vision acuity test, either: Jaeger No. 1 at not less than 12 inches (30.48 cm) or 20/25 (Snellen) at 16" (40.64 cm) \pm 1" (2.54cm), in at least one eye for any of the previ-

ous tests or, Tumbling E IAW ISO 18490 annually while certified. The near vision test is required for only one eye either natural or corrected. When vision correction is necessary to pass the visual acuity exam, vision correction SHALL be worn during all inspections.

1.2.5.2 Color Perception Requirements. All NDI personnel SHALL receive a color perception test prior to initial certification. Any limitations on color perception SHALL be placed in the individual's training records. Personnel certified to NAS 410 SHALL have any limitations to color perception evaluated by the Responsible Level 3 and approved in writing prior to certification.

1.2.6 Requirement for Special Task Certification and Recurring Training.

1.2.6.1 Air Force. The weapon system SPO, ALC NDI Manager, or lab supervisor determines special task certification and recurring training for NDI tasks. Document special task certification IAW AFIs 21-101, 36-2670, and/or local directives. Inspections performed on Safety of Flight and/or safety critical structures or parts that require special task certification SHALL be specifically noted as "Special Task Certification Required" in the weapon system NDI manual. Task certification is only required if the Safety of Flight inspection is performed by the maintenance activity. For Depot laboratories, task certifications may be grouped together when techniques are similar in nature and/or complexity. Laboratory supervisors have the discretion to add additional tasks as a requirement for their specific laboratory. The initiating office generally determines the training interval and provides specific guidance and criteria for certification.

1.2.6.1.1 Computed Radiography Supplemental Training. Military NDI technicians who have not completed the Non-destructive Inspection Apprentice Course with Computed Radiography training (Course Number: JCABP2A732 048D) SHALL receive 40 hours of supplemental training on Computed Radiography when transitioning from film to non-film inspection methods. Training completion SHALL be accomplished prior to 31 Dec 2025. Civil Service and Contractors SHALL meet this requirement IAW NAS 410 Rev 4.

1.2.6.2 Army. Active Duty and Reserve personnel SHALL receive a minimum of sixteen (16) hours of NDT refresher training every 3 years. Documentation of topics covered, course duration, personnel in attendance, and course instructor shall be available in hard copy or electronic format.

1.2.6.2.1 Task Specific Qualification (TSQ). TSQ evaluations SHALL cover portable penetrant testing, portable magnetic particle testing, surface eddy current testing, and ultrasonic testing on tasks that are typical of those to be accomplished on weapon platforms supported by the Unit. Recurring NDT inspections with specialty kits shall also be assessed and Task Specific Qualified. TSQ evaluations SHALL be conducted and documented on an annual basis to validate inspector proficiency and currency.

1.2.6.2.2 Refresher Training. Active Duty and Reserve personnel SHALL receive a minimum of sixteen (16) hours of NDT refresher training every 3 years. Acceptable forms of refresher training shall include but not be limited to:

1. Documentation of self-study - 8 hours maximum.
2. Structured refresher training locally hosted by the unit/support unit (SGT's time training), Theater Aviation Sustainment Maintenance Group/Depot (TASMG/CCAD), or Redstone Arsenal (NDT Center of Excellence). Contact the NDT Center of Excellence at COM: (256) 842-8211, DSN: 788-8211, or email: usarmy.redstone.devcom-avmc.mbx.ndt-coe@army.mil to coordinate a training course.

Documentation of topics covered, course duration, personnel in attendance, and course instructor shall be available in hard copy or electronic format.

1.2.7 Evaluation of NDI Personnel.

NOTE

- NDI Quality Assurance (QA) Personnel Evaluation (PE) Checklists were developed using TO 33B-1-2 for common/general NDI applications.
- For tasks evaluated using weapon system technical data (e.g., -9, -36, etc.), the checklists should be used as a guideline. Under these circumstances, any missed checklist item(s) shall not be documented as a finding during an evaluation unless specifically directed in the applicable technical data required for the task evaluated.

1.2.7.1 Air Logistic Complex (ALC) Depot Personnel. Civilians, to include contracted depot personnel, will be evaluated on each NDI method as established in AFMCI 21-100 and AFSCI 20-114. For Quality Assurance (QA) evaluations, the PE checklists for the five main NDI methods are located on the AF NDI SharePoint (<https://usaf.dps.mil/teams/22399/SitePages/Home.aspx>) and SHALL be utilized to supplement local QA evaluation requirements. QA evaluations conducted SHALL be appropriate to the skill level and experience of the technician. STANDALONE performance of a process control does NOT capture technical proficiency and SHALL NOT be used for a PE (exception: ultrasonic and computed radiography system test evaluation process controls may be used). PE documentation SHALL include each individual methods completion (e.g. methods tracked/documented individually). NDI personnel without a current PE documented SHALL NOT perform tasks associated with the NDI method.

1.2.7.2 Air Force Field Personnel. Military and civilians, to include contractor personnel, will be evaluated by QA on each NDI method performed at intervals established in AFI 21-101. QA Inspectors and Augmentees evaluating NDI methods SHALL have a current PE for each NDI method being evaluated (exception: shearography and thermography methods). PE checklists for the five main methods are located on the AF NDI SharePoint (<https://usaf.dps.mil/teams/22399/SitePages/Home.aspx>) and SHALL be utilized to supplement local QA evaluation requirements. QA evaluations conducted SHALL be appropriate to the skill level and experience of the technician. STANDALONE performance of a process control does NOT capture technical proficiency and SHALL NOT be used for a PE (exception: ultrasonic and computed radiography system test evaluation process controls may be used). PE documentation SHALL include each individual methods completion (e.g. methods tracked/documented individually). NDI personnel without a current PE documented SHALL NOT perform tasks associated with the NDI method.

1.2.8 Training & Evaluation Aids for Air Force Personnel.

1.2.8.1 Training Aids. For a training program to be successful, a variety of parts and test specimens are needed to perform hands-on training. In addition to authorized standards and unserviceable weapon system parts, locally manufactured training aids can be constructed to support hands-on training. Training aids should be used (when practical) during training of NDI methods and procedures. Approved plans for local construction of training aids are available on the AF NDI SharePoint (<https://usaf.dps.mil/teams/22399/SitePages/Home.aspx#>) and are recommended to be used as a supplemental resource for trainees, trainers and certifiers.

1.2.8.2 Evaluation Aids. Evaluation aids are designated training aids which are only used for certification and Quality Assurance (QA) Personnel Evaluations (PEs). They should be kept separate from training aids, with access limited to NDI laboratory supervision and QA personnel. Approved plans for local construction of evaluation aids are available on the AF NDI SharePoint (<https://usaf.dps.mil/teams/22399/SitePages/Home.aspx#>) and are recommended to be used as a supplemental resource for certifiers and QA Inspectors and Augmentees.

EDDY CURRENT	UNITED STATES AIR FORCE NONDESTRUCTIVE INSPECTION (NDI) EXPERIENCE HOUR LOG			
EXPERIENCE RECORD FOR: _____ PERIOD: _____ TO _____				
TASK PERFORMED	DATE	HIGH FREQUENCY SURFACE SCAN	ROTARY FASTENER HOLE	LOW FREQUENCY SURFACE SCAN
SUPERVISOR SIGNATURE/DATE:	-----	-----	-----	-----
	-----	-----	-----	-----

AF IMT 3126, 20060215, V1 GENERAL PURPOSE (8 1/2 x 11")

H1502512

Figure 1-1. EXAMPLE EXPERIENCE HOURS DOCUMENTATION RECORD

SECTION III REPORTING DEVELOPMENT OF NDI PROCEDURES & REPORTING OF NEW OR IMPROVED NDI TECHNIQUES

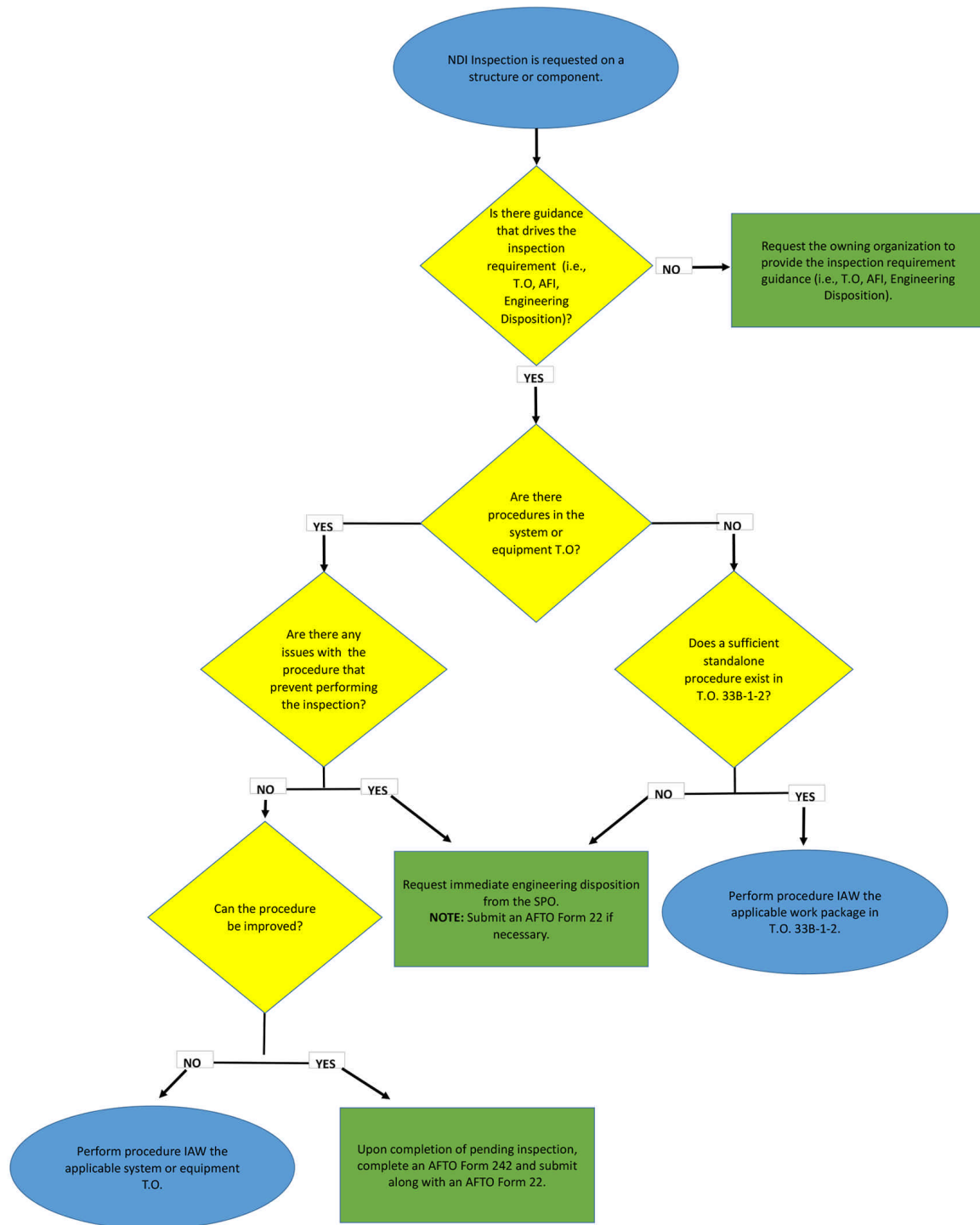
1.3 DEVELOPMENT OF NDI PROCEDURES & REPORTING OF NEW OR IMPROVED NDI TECHNIQUES.

1.3.1 Need for NDI Procedural Development and Authority. Due to the complexity and level of instruction required to successfully perform NDI, it is critical that detailed procedures are developed, reviewed, and approved by an NDI Level 3. Technical Orders and NDI procedures are developed IAW this technical order and EN-SB-15-002. The Air Force NDI Office (AFLCMC/EZPT-NDIO) is the Air Force OPR for the NDI program. System Program Offices and other engineering agencies seeking to develop NDI procedures IAW TO 00-5-3, AF Technical Order Life Cycle Management and TO 00-5-15, AF Time Compliance Technical Order Process shall contact the AF NDI Office or the appropriate NDI Manager listed below to provide Level 3 NDI services.

- Air Force NDI Office, AFLCMC/EZPT-NDIO, DSN 339-4931, Comm. 405-739-4931, aflcmc-ezpt-ndio@us.af.mil
- Technical Content Manager (33B Series TOs), Air Force NDI Office, AFLCMC/EZPT-NDIO, DSN 884-0884, Comm. 405-734-0884
- Air Force Sustainment Center NDI Manager, AFSC/ENSI, DSN 336-5008, Comm. 405-736-5008
- Ogden Air Logistics Complex (OO-ALC) NDI Manager, 809 MXSS/MXDEA, DSN 775-2483, Comm. 801-775-2483
- Oklahoma City Air Logistics Complex (OC-ALC) NDI Manager, 76 AMXG/MXDEN, DSN 852-6129, Comm: 405-582-6129
- Warner Robins Air Logistic Complex (WR-ALC) NDI Manager, AFSC/ENRB, DSN 497-4099, Comm. 478-327-4099
- Air Force Research Laboratory, AFRL/RXSA, DSN 986-9151, Comm. 937-657-9514
- (Army) NDT Center of Excellence (CoE) FCDD-AMT-MPA-MS, DSN 788-8211, Comm. 256-842-8211

1.3.2 Need for Reporting New and Improved Techniques. Developing new NDI techniques is expensive and time consuming. In addition, techniques and procedures can be applied to all aircraft where similar problems exist. Interchanging information on newly developed NDI techniques between operating commands will reduce maintenance costs and enhance safety. It is always beneficial to check with your MAJCOM Functional, ALC NDI Manager, and the AF NDI Office to see if other bases have been experiencing the same problems. This section prescribes the procedures for reporting the development of new or improved nondestructive inspection techniques. It also provides for the reporting of a NDI method application to a part or item not previously inspected by NDI methods. The authority for reporting new or improved NDI techniques or new applications of NDI methods is contained in this technical order and shall be used in conjunction with TO 00-5-1, AF Technical Order System.

1.3.3 New NDI Techniques, Procedures, and Applications. New NDI techniques, procedure, and applications for existing or new aircraft, engines, or support equipment shall include, where applicable, fluorescent penetrant, magnetic particle, eddy current, ultrasonic, radiographic, and other specialized methods when required to provide inspection capability. Procedures shall be in the Work Package (WP) and Subordinate Work Package (SWP) formats as described in MIL-DTL-87929. General procedures detailed in TO 33B-1-2 shall be used to the greatest extent possible to avoid development of standalone procedures. New and modified procedures shall be validated and verified as described in AFLCMC/EZ Structures Bulletin, EZ-SB-15-002. Air Force personnel should refer to the flow chart to assist qualified technicians with determining proper inspection guidance and if new or improved techniques need to be reported ([Figure 1-2](#)).



NOTE: The AFTO Form 242 can be used along with the AFTO Form 22 to update and create new procedures when none are available, however it SHALL NOT be used as standalone guidance or as an inspection procedure when no Technical Data exists or is available. Engineering disposition instructions and general procedures in T.O. 33B-1-2 SHALL be used to the greatest extent possible.

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Figure 1-2. Flow Chart for Determining Inspection Guidance

1.3.4 AFTO Form 242. The AFTO Form 242 permits detailed feedback and interchange of new or improved NDI techniques, procedures, and applications from base-level NDI laboratories to the System Program Offices (SPO), Air Logistics Complexes (ALC), and other NDI operational facilities. The Army equivalent of AFTO Form 242 is DA Form 2028 ([Paragraph 1.3.6.5](#)). Navy and Marine Corps personnel MAY use the AFTO Form 242 or a local equivalent containing all relevant information ([Paragraph 1.3.7](#)), and forward via the Aircraft Controlling Custodian/Type Commander (ACC/TYCOM) to the cognizant Fleet Support Team (FST).

NOTE

AFTO Form 242's SHALL NOT be used as a stand-alone inspection document. The AFTO Form 22 and AFTO Form 242 SHALL be submitted to the responsible System Program Office (SPO) and placed in the proper technical manual prior to being used as inspection guidance.

1.3.5 Scope. The procedures prescribed herein apply to all Major Commands (MAJCOM) operating NDI Laboratories per AFI 21-101.

1.3.5.1 An AFTO Form 242 SHALL be submitted whenever an NDI technique is developed, improved, or is considered desirable and is not sufficiently described or contained in existing manuals. An AFTO Form 242 SHALL NOT be used in the following cases:

- Reporting minor technical inaccuracies in NDI involving the use of the same technique.
- Reporting techniques requiring the use of nonstandard equipment not listed in Allowance Standard (AS) 455. However, this does not include locally manufactured shoes, holders, or wedges for use with AS 455 equipment. Reporting requirements for equipment evaluation will be provided by the AF NDI Program Manager and directed by the MAJCOM NDI Functional Manager.
- Reporting changes or deficiencies in inspection requirements, such as contained in Technical Orders/Maintenance Manuals.

1.3.6 Responsibilities for Updating Techniques.

1.3.6.1 Initiator. The initiator SHALL initiate and complete the applicable sections of the AFTO Form 242 in accordance with the instructions prescribed in subsequent paragraphs (see [Paragraph 1.3.7](#)). An initiator is any NDI technician who:

- Develops an NDI technique or procedure not presently contained in the existing NDI applications manuals or other applicable TO manuals, or
- Improves an existing NDI procedure, or
- Determines an area or condition where an NDI procedure would be advantageous.

1.3.6.1.1 The initiator SHALL also prepare an AFTO Form 22 in accordance with TO 00-5-1 to serve as a processing document for the AFTO Form 242. The AFTO Form 22 SHALL cite the NDI applications manual (-9, -36, etc.) for the applicable weapon system or other manual in which the proposed procedure should be incorporated. On commodity items that do not have an NDI applications manual, the technical order manual containing service, operating, and maintenance instructions SHALL be cited. One copy of the AFTO Form 242 SHALL be attached to each copy of AFTO Form 22.

1.3.6.2 Initiator's Supervisor. The supervisor of the person submitting a recommended change will ensure the recommendation is valid and warrants submittal. A fully certified NDI technician (e.g., AFSC 2A772, NAS 410 Level 2, etc.) other than the originator SHALL witness the demonstration of the complete procedure to ensure its technical adequacy and accuracy.

1.3.6.2.1 In cases when there are no inspection procedures available, the laboratory supervisor SHALL request immediate engineering disposition from the owning SPO responsible for that weapon system or commodity. The ALC NDI Manager should be able to help you identify a good Point of Contact (POC) within that office. The laboratory supervisor SHALL send via: phone, fax, or e-mail, a request for inspection instructions/approval IAW TO 00-25-107. Send a courtesy copy of this information to the ALC NDI Manager.

NOTE

An AFTO Form 242 associated with non-weapon system support equipment items (hooks, AGE, etc.) may be approved by the local lab supervisor. The supervisor SHALL submit the AFTO Forms 22 and 242 to incorporate the procedure into the applicable technical order.

1.3.6.2.2 After verifying the technique, the supervisor SHALL forward the AFTO Forms 22 and 242 to the responsible SPO and the appropriate ALC NDI Manager. AFTO FORM 242 inspections SHALL NOT be used to perform inspections on aircraft until approved by the appropriate SPO.

1.3.6.3 System Program Office (SPO). The SPO SHALL coordinate efforts with the responsible ALC NDI Manager or their designee to ensure all AFTO Forms 22 and 242 submitted for NDI suggestions are reviewed for technical accuracy. Upon approval of the recommended change, the SPO SHALL provide immediate guidance to all users of the affected manual by issuing a message to be incorporated into the manual until a Block Cycle Update (BCU) or Rapid Action Change (RAC) is submitted for incorporation into the affected manual.

1.3.6.4 Air Logistics Complex (ALC) NDI Manager. The ALC NDI Manager or their designee is responsible for ensuring the technical accuracy of the technique. As the lead NDI Level 3 for the ALC, this person SHALL use all available assets to add, revise, or supplement the submitted technique as required to produce a workable procedure. The ALC NDI Manager or designee SHALL validate the technique and return this information to the SPO to take action on field notification and include it in the appropriate technical order.

1.3.6.5 Army Personnel Technique Development. The Army uses DA Form 2028 when developing an NDI technique or procedure not presently contained in existing manuals. AFTO Forms may be reproduced and used to supplement DA Form 2028. Send comments and suggested changes through the AMCOM Publications System: <https://amcom2028.redstone.army.mil> or by fax on DD Form 2028 to DSN 788-6546 or Commercial (256) 842-6546.

1.3.7 AFTO Form 242 Entries.

NOTE

If it is not possible to provide a complete detailed description of the NDI technique on a single AFTO Form 242, the form SHALL be supplemented with additional sheets of plain white paper.

Entries for inspection methods are similar and are described in the appropriate paragraphs. The first twelve blocks on AFTO Form 242 are used to identify the submitting initiators contact information and the information for the actual part or component to be inspected. It also provides space for a description of the condition or reason for the inspection. The instructions for completing these twelve blocks are provided in the following paragraphs.

1.3.7.1 Block 1 (Control Number). This is a standardized number that reflects the command and organization developing the technique and method used. The control number SHALL be made up of three series of numbers and letters as follows:

- Two digits of the calendar year with an alphabetic character designating the applicable NDI method code ([Table 1-1](#)). If more than one inspection method is used to determine the integrity of a part, and both techniques are listed on the same AFTO Form 242, use a letter for each inspection method, (e.g., 86CA) with the letter for the primary inspection method being listed first.
- The code for the major command ([Table 1-2](#)) and the organization or unit number of the technique originator.
- A sequential number assigned by the originating organization without regard for method of inspection or calendar year. Example, Report/Control No. 04A-T366-12 will be shown as:

04 - represents the calendar year 2004
A - represents the method code for penetrant inspection
T - represents the Major Command Code for ACC
366 - represents the Unit Number, i.e., 366th Maintenance Squadron
12 - represents the twelfth technique submitted by the 366th MXS

Table 1-1. NDI Method Codes

NDI Method	Method Code
Penetrant	A
Magnetic Particle	B
Eddy Current	C
Ultrasonic	D
Radiographic	E

Table 1-2. Major Command Codes

Major Command	Command Code
US Air Forces Europe (USAFE)	D
Air Force Materiel Command (AFMC)	E
Air Force Global Strike Command (AFGSC)	G
Air Force Education and Training Command (AETC)	J
Air Force Reserve (AFRES)	M
Air Combat Command (ACC)	T
Air Mobility Command (AMC)	Q
Air Force Special Operations Command (AFSOC)	S
US Air Force Pacific (PACAF)	R
Air National Guard (ANG)	Z

1.3.7.2 **Block 2 (Organization and Base)**. Example: 366 MXS, Mountain Home AFB, ID.

1.3.7.3 **Block 3 (End Item (M/D/S))**. Enter the major end item on which the part/area to be inspected is installed. Include the Mission/Designator/Series (M/D/S) or Federal Stock Class (FSC) number, as applicable.

1.3.7.4 **Block 4 (Nomenclature)**. Specify the name of item/component or assembly to be inspected.

1.3.7.5 **Block 5 (Part/Assembly Number)**. Enter part or assembly number of the item to be inspected.

1.3.7.6 **Block 6 (TO Number)**. Enter technical order number of illustrated parts manual or service and maintenance manual that shows the item/assembly to be inspected. Enter page, figure, index number, and date of issue of the manual where applicable.

1.3.7.7 **Block 7 (Next Higher Assembly)**. Enter name and part number of next higher assembly. If there is insufficient space, complete the entry on a continuation sheet of plain bond paper.

1.3.7.8 **Block 8 (Manufacture/Serial Number)**. Enter manufacturer's name and serial number as applicable.

1.3.7.9 **Block 9 (Initiator and Phone Number)**. Enter the name, rank, and phone number of initiator or person who developed the technique.

1.3.7.10 **Block 10 (Description of Defect/Condition or Reason for Inspection)**. Provide a narrative description of defect/condition or reason for inspection. Narration SHALL include location and orientation of the expected discrepancy if known.

1.3.7.11 **Block 11**. Place a check mark or an "X" in appropriate block indicating whether inspection is performed with part installed or removed.

1.3.7.12 Block 12 (Part Preparation). Describe any disassembly or system preparation necessary. Examples: "Remove retaining bolt P/N 1, lower inboard flaps" or "Remove access cover number 001." Also, describe any part preparation requirements.

SECTION IV NDI EQUIPMENT

1.4 PROCURING NDI EQUIPMENT (AIR FORCE ONLY).

1.4.1 Centrally Procured NDI Equipment. Centrally procured NDI equipment is purchased by the Support Equipment and Vehicle Management Directorate at Warner-Robins AFB (AFLCMC/WNZ) using special support equipment funding (called 3010/BP12 funds). They calculate requirements using valid requisitions within the Defense Property Accountability System (DPAS), submitted by local units.

NOTE

- When placing equipment backorders, the master NSN number should be used, NOT equipment specific NSNs. Master NSNs for major equipment items follows.
- Detector, Metal Flaw, Electronic (Eddy current), NSN 6635-00-463-1574
- Fluorescent Penetrant Inspection Unit (PT-48), NSN 6635-00-110-9463
- Interlock Assembly, X-ray Safety, NSN 6635-01-508-1519
- Magnetic Inspection Unit, Stationary (100 inch), NSN 6635-00-361-4631
- Test Set, Ultrasonic (Bond tester), NSN 6635-01-161-4551
- Test Set, Ultrasonic, NSN 6635-01-363-6674
- X-ray Apparatus, Radiographic, Industrial, NSN 6635-01-394-5926
- X-ray Equipment, Industrial (Computed radiography), NSN 6635-01-523-5766

1.4.1.1 Allowance Standard (AS) 455. This document identifies the types and quantities of centrally procured, weapon system specific, and special purpose NDI support equipment authorized for both field and depot NDI organizations. AFLCMC-WNZ manages all allowance standards for HQ USAF.

1.4.1.2 Purpose of Centrally Procured NDI Equipment. HQ USAF directs the use of standardized NDI equipment and processes whenever possible, and has assigned engineering authority for this direction to the: AFNDIO, AFLCMC/EZPT-NDIO, Tinker AFB, OK. The use of centrally procured equipment reduces the initial cost of the equipment and any associated repairs. It also reduces technical manual updates/changes and reduces training costs. The AFNDIO coordinates efforts with the MAJCOMs, ALCs, and the other branches of service before new procurements to determine specific technical requirements. During the acquisition process, new equipment is both laboratory and field tested to ensure safety, deployability, sensitivity, repeatability, and maintainability. After structural engineers within the SPO have identified an inspection requirement, the (ALC/SPO/Contractor) NDI Level 3 will develop an inspection procedure using centrally procured NDI equipment whenever possible. The use of non-standard NDI equipment must be coordinated through the SPO, AS 455 Manager, and the AFNDIO.

1.4.2 Weapon System Specific/Special Purpose Equipment.

CAUTION

- Equipment purchased for specific weapons systems or other purposes SHALL NOT be used to substitute for equipment or to conduct inspections designed for equipment listed in AS 455. Equipment purchased in this manner SHALL ONLY be used when written permission and procedures have been authorized by the specific SPO. The laboratory supervisor SHALL maintain a copy of this written authorization with the equipment. Navy field activities SHALL obtain authorization to substitute NDI equipment from the cognizant engineering authority.
- On occasion, equipment may be required for specific tasks associated with specific weapon systems. This equipment is called out within NDI technical manuals (-9, -36, etc.) or in some cases by an official letter or message. Equipment called for in this method should be purchased and maintained by the SPO requiring the inspection.

1.4.3 Local Purchase Equipment. Equipment items for nondestructive inspections SHALL NOT be purchased locally without the knowledge and approval of the responsible ALC manager or the NDI Program Office. Consumable support items and replacement parts may be purchased at any time without ALC manager or the NDI Program Office approval.

SECTION V PROCESS CONTROL

1.5 PROCESS CONTROL.

NOTE

Process controls are discussed in section six of Chapters 2 through 6 of this manual. Specific process control procedures are located in TO 33B-1-2, *Nondestructive Inspection General Procedures and Process Controls*.

1.5.1 Reason for Controlling the Process. Process control is an essential ingredient in achieving consistent and reliable results with NDI inspections. A well regimented NDI process control program will not allow conditions to develop that render inspection methods as a source of misinformation. This misinformation may take two forms: 1) When NDI determines a part is defective, when in truth it is not, resulting in a false call. This is a waste of resources and an unnecessary reduction in mission capability. 2) Even more dangerous is determining a part to be serviceable when in fact it is defective resulting in a missed call. Both forms of misinformation can be minimized through the implementation of effective process control.

1.5.2 Scope of Process Control. All areas are interrelated. They have to be tuned to each other to achieve valid inspection results. If any one of these requirements is altered, the final outcome of the inspection will change, regardless of the inspector's proficiency. All frequency requirements for method specific process control checks are published in TO 33B-1-2.

1.5.2.1 Process control is a general term used to encompass the actions and documentation required by established directives and logic. These controls are necessary for an NDI method to be effective in detecting conditions of interest (e.g., cracks, foreign objects, corrosion, alignment of parts, and thickness of parts).

1.5.2.2 Areas that fall within the scope of process control are as follows:

- Training and the demonstrated practical skills of inspectors.
- Inspection environment. (e.g., temperature, specific type and levels of light, safety, and human engineering.)
- Material control. (e.g., serviceability of ultrasonic transducers, eddy current probes, penetrant materials, X-ray film and chemicals, and magnetic particle suspensions.)
- Equipment control. (e.g., operational and performance capability or Test Measurement Diagnostic Equipment (TMDE)/user calibration.)

- Written inspection instructions. (e.g., adequate, -9, -26, and -36 technical orders and Time Compliance Technical Orders (TCTOs).)
- Adherence to written inspection instructions. (e.g., distinguishing requirements dictated by specific NDI procedures versus commonly accepted basic NDI practices.)

NOTE

Process controls do not fall within the scope of equipment servicing or inspections.

1.5.2.3 (Air Force Only). Process control requirements are outlined in TO 33B-1-2 for centrally procured equipment or equivalent and authorized tooling. Process control practices for equipment not documented in TO 33B-1-2 shall be developed and approved by the governing ALC NDI Level 3. When developing process controls, considerations for electronics, output, and materials should be included where applicable. System effectiveness checks shall also be considered where calibration with a reference standard is not used for the procedure. Industry standards should be reviewed for applicability and used or incorporated whenever possible. Equipment and techniques that may be included in this category are infrared/thermography, shearography, automated ultrasonic or eddy current, phased array ultrasonic, and digital radiography techniques. Periodic calibration by the equipment manufacturer may satisfy all or part of process controls.

1.5.2.4 Equipment Maintenance. Operator maintenance, when performed properly, is another essential ingredient to ensuring the equipment operates as required. The equipment's necessary inspection and maintenance requirements are determined by applicable technical data, equipment manuals, or engineering data.

1.5.2.4.1 (Air Force Only) Depot Labs. All equipment being utilized in a depot industrial maintenance area is outlined in AFSCMAN 21-102. Documentation procedures for the inspection and maintenance of this equipment type are outlined in AFMCI 21-100 and TO 34-1-3.

1.5.2.4.2 (Air force Only) Field Labs. Field level NDI equipment does not fall under the definition of common support equipment listed in TO 00-20-1. NDI equipment being utilized in organizational and intermediate maintenance facilities is referred to as "non-depot industrial support equipment (shop equipment)". Documentation procedures for the inspection and maintenance of this equipment type are outlined in TO 34-1-3.

1.5.3 Process Control Documentation Requirements. Documentation of process controls are completed to verify conformance to established requirements in the areas described in [Paragraph 1.5.2](#). The requirements prescribed within this technical order apply to all Air Force, Navy, Army, and Marine Corp units that use Nondestructive Inspection Laboratories.

1.5.3.1 Separate documentation SHALL be maintained for each NDI method, equipment, and material with established process control requirements. Process control requirements SHALL NOT be documented on the same form used for equipment maintenance, (See [Figure 1-3](#) and [Figure 1-4](#)), but may be documented on the same type of form. As a minimum, this documentation SHALL reflect each element of process control with respect to required time intervals between checks, date of accomplishment for each check, condition of element checked, corrective action taken (if required), initials of the person performing test, serial number or identification number of the element tested, manufacturer, NSN or Part Number if applicable.

1.5.3.2 Filing (Air Force Only). File and dispose of all records IAW Air Force Records Information Management System (AFRIMS) and AFI 33-322.

1.5.3.2.1 Historical File. Establish and maintain historical files, in accordance with AFI 33-322 and this TO for each NDI method, equipment, and material with established process control requirements. The historical file may include hard or electronic copies. Maintenance Information Systems, Computer based software products, and paper copy forms may contain a difference in format, but must contain all required information.

1.5.3.3 Disposition. Dispose of all records IAW AFI 33-322. Refer to the applicable Air Force Records Disposition Schedule in AFRIMS.

PCAMS: Add/Edit Equipment or Inspections Form

ADD/EDIT EQUIPMENT OR INSPECTIONS

EQUIPMENT ID: 001

EQUIPMENT: MPI Bench (Eqmpt Mx) **MFR:** Gould-Bass

NSN: 6635-00-361-4631 **PART NO:** GB-3509A-01

TECH ORDER: Owner's Manual **WUC:** N/A

INSPECTIONS **SERIAL NUMBERS**

INSPECTION	MATERIALS REQUIRED	INTERVAL	PAGE	PARA
Clean Sump Screen & Agitator Jets	PPE & Owner's Manual	1	35	5-1
Air Filter Check	Owner's Manual	7	35	5-2
Electrical Component Cleaning	Owner's Manual/Compress	30	35	5-3
*				

Record: 1 of 3 No Filter Search

Record: 1 of 4 No Filter Search

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Figure 1-3. PCAMS Form, Equipment Maintenance Only

ADD/EDIT EQUIPMENT OR INSPECTIONS

EQUIPMENT ID: 002

EQUIPMENT: MPI Bench (Process Controls) **MFR:** Gould-Bass

NSN: 6635-00-361-4631 **PART NO:** GB-3509A-01

TECH ORDER: TO 33B-1-2 **WUC:** N/A

INSPECTIONS SERIAL NUMBERS

INSPECTION	MATERIALS REQUIRED	INTERVAL	PAGE	PARA
UV-A (Black Light) Intensity Check	WP 103 00 & Radiometer	1	14	4.11
System Effectiveness Check	WP 103 00 & PPE	1	5	4.1
Concentration/Suspension Settling Test	WP 103 00 & PPE	1	15/17	4.14/4.15
Ambient Light Check	WP 103 00 & Radiometer	60	14	4.11
Quick Break Test	WP 103 00 & Quick Break	90	8	4.7

Record: 1 of 6 No Filter Search

Update Inspections Close Form

Record: 2 of 4 No Filter Search

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Figure 1-4. PCAMS Form, Process Controls Only

1.5.4 Establishing a Documentation Method. Each MAJCOM Functional Manager SHALL determine the method their assigned NDI laboratories will utilize for documenting process control verification. Army units will maintain records of process control requirements at the unit level. NDI laboratory managers will contact their MAJCOM Functional Manager when special circumstances restrict their ability to document using the established method (e.g., TDY, deployments).

1.5.5 Suggested Documentation Method. The use of a general-purpose form or computer database is relatively inexpensive and could be easily formatted to fit specific NDI method and equipment process control requirements. An alternative to the general-purpose form is to interface process control with a computer, utilizing the Process Control Automated Management System (PCAMS) tool, which was developed for use in the Air Force Nondestructive Inspection career field. The Air Force NDI Office (AFNDIO) has authorized and highly recommends the use of this program to document process controls. See TO 00-20-1 for documentation guidance of the AFTO Form 244 for equipment maintenance.

NOTE

Process controls are not required to be recorded on the AFTO Form 244.

1.5.5.1 Process Control Automated Management System (PCAMS). The Process Control Automated Management System (PCAMS) tool, is a database developed for the NDI career field in an effort to reduce paper and improve the management of process controls and equipment maintenance (AFTO Form 244). PCAMS is a relational database within the latest version of the Microsoft Access™ application. Microsoft Access is part of the Air Force's Standard Desktop Configuration accreditation package. When using PCAMS as your documentation tool there are a few minimal steps to follow:

NOTE

- Prior to inspecting a weapon system or support equipment component, technicians SHALL review PCAMS for the current status of the applicable method, equipment, and/or material being used.
 - Air Force organizations SHALL use the most recent version of PCAMS provided by the Air Force NDI Office located on the AF NDI SharePoint (<https://usaf.dps.mil/teams/22399/sitepages/home.aspx>). Users should validate their database at least every 90 days to ensure the organization is using the most recent version.
 - Daily inspection reports are for reference use only and should not be considered an official record.
- a. Each shift supervisor SHALL review PCAMS at the beginning of each shift to verify any equipment problems.
 - b. Sign off inspections in the database as they are completed by providing the qualified technician's employee information, who performed each inspection, and the date it was completed.
 - c. Back-up PCAMS at least once a week. This backup must be kept separate from the PCAMS file and stored electronically in a separate file location/directory (e.g., hard drive, CD, etc.).
 - d. Unless otherwise specified in TO 33B-1-2, process controls performed at "prior to use" intervals SHALL be documented as Non-Scheduled Inspections. Intervals designated as "daily or prior to use" SHALL NOT be documented as a Non-Scheduled inspection if the equipment is in daily use.
 - e. A comprehensive supervisory review of ALL process controls SHALL be conducted every 180 days. The comprehensive review verifies all documentation is properly documented, contains all required information, and no discrepancies exist. The review is not completed until ALL identified discrepancies have been corrected. Supervisory reviews SHALL be accomplished by the lab supervisor (or trusted agent). Reviewers must provide their employee information, and provide the date the review was accomplished.
 - f. The AFTO Form 244 software function within PCAMS is only required for documentation of equipment maintenance, inspection and discrepancies. The form will be printed out to accompany support equipment when conditions listed in TO 00-20-1 exist.

SECTION VI LABORATORY INFORMATION

1.6 GENERAL LABORATORY INFORMATION.

1.6.1 Constructing a Nondestructive Inspection Laboratory. This section describes a typical Nondestructive Inspection (NDI) Laboratory. Publications, which may provide the Civil Engineers more guidance for constructing these facilities, are AFMAN 32-1084, AFI 32-1023, and any applicable Engineering Technical Letters (ETL). AFMAN 32-1084 lists the NDI Lab as Category Code 211-153. It is important to consider current AND future mission requirements when planning to size your laboratory. A larger or modified facility may be warranted depending on which weapon system(s) may be serviced and it may be cost prohibitive to expand at a later date. [Figure 1-5](#) shows a typical floor plan reflecting the MINIMUM requirements (4000 Sq Ft) for a full laboratory. IAW AFMAN 32-1084, undergraduate pilot training (UPT) bases and bases with F-15 aircraft are authorized space for an X-ray exposure room that can accommodate an entire aircraft. Due to local building codes and state environmental regulations each laboratory may vary slightly. The floor plan in [Figure 1-5](#) and the associated notes SHOULD be used in conjunction with both the applicable manufacturer's installation instructions for current equipment required and the information provided in the radiation protection section of [Paragraph 6.8](#) in [Chapter 6](#) of this technical order.

NOTE

- Other offices/organizations to contact for information include but aren't limited to: the base Bioenvironmental Engineering, the base Safety Office, and the local Environmental Protection Agency (EPA).
- (AF PERSONNEL) Prior to planning, constructing, or modifying a new or current facility, the Laboratory Supervisor SHALL contact the Air Force NDI Office (AFNDIO): AFLCMC/EZPT-NDIO, aflcmc-ezpt-ndio@us.af.mil, DSN 339-4931 for guidance. It may be necessary to submit a copy of the proposed floor plans for review.
- (NAVY PERSONNEL) Navy and Marine Corps radiographic facilities SHALL comply with NAVSEA S0420-AA-RAD-010.
- (ARMY PERSONNEL) Prior to planning, constructing, or modifying a new or current facility, the supervisor SHALL contact U.S. Army Combat Capabilities Development Command (CCDC), Aviation and Missile Center (AvMC), NDT Team, FCDD-AMT-MPA-MS, Bldg. 7631, Redstone Arsenal, AL 35898; DSN: 788-8211.

1.6.2 Building Requirements.

- A ceiling height of 10-feet is required throughout the facility with the exception of (Rooms 1, 7, 8, and 12).
- Clear ceiling height in the X-ray exposure room (Room 1) SHOULD be 12-feet where practical, to avoid difference in roof level. The height MAY be 14-feet where the using command can justify it on the basis of sizes of components to be inspected in the foreseeable future.

NOTE

Door and monorail between (Rooms 1 and 8) are optional. Where a monorail is provided, adjust the ceiling heights in both rooms to suit the monorail operation.

- Size of the lead-faced doors into the exposure room depend on the size of items to be inspected. These doors SHOULD be as small as practical for efficient operation. The door between (Rooms 1 and 8) can be above the floor, at any height to suit operations as long as all safety concerns are met and approved by the Bioenvironmental Engineering Office.
- Materials and construction SHALL be in accordance with AFI 32-1023.
- The category construction of this building is to be "permanent non-combustible."

1.6.2.1 X-Ray and Environmental Protection.

CAUTION

- For additional guidance see [Paragraph 6.8](#) in [Chapter 6](#) of this technical manual.
- Radiation shielding, barricades, and warning devices are dependent on each specific X-ray operation and equipment being used. Contact the local Bioenvironmental Engineering Office to calculate formulas that will meet or exceed current radiation protection design and equipment technology.

1.6.2.2 Radiation exposure (Room 1) SHALL conform to the requirements specified in the HPS ANSI/HPS N43.3 "For General Radiation Safety – Installations Using Non-Medical X-Ray and Sealed Gamma-Ray Sources, Energies Up to 10 MeV." This standard establishes guidance for the design and use of installations that use X-ray generating devices and sealed gamma-ray sources of energies up to 10 MeV for non-medical purposes. Bioenvironmental Engineers or health physicists SHALL be consulted for help in interpreting HPS ANSI/HPS N43.3 and performing shielding calculations. Review [Paragraph 6.8.8](#) through [Paragraph 6.8.8.4.9](#) for additional information.

1.6.2.3 If use of radioisotopes is anticipated, this SHALL receive additional consideration when calculating shielding requirements.

WARNING

Buildings NOT equipped with ceiling shielding SHALL consider that maintenance personnel may place a ladder at any location along the roof of the building or have blind access from another location within the building. "Warning sign(s), rope barriers, and when possible, access locking mechanism(s) " SHALL be used at all access points to warn personnel and notify them to check in with the NDI Laboratory Supervisor to ensure X-ray operations are not taking place while personnel are in the area.

1.6.2.4 Radiation protection shielding SHALL be used on the ceiling of the exposure room when required by shielding calculations. When ceiling shielding IS NOT provided, a barrier limiting access to the portion of roof above the exposure facility SHALL be used with a warning sign and light at each point of access.

1.6.2.5 The design and specifications for the NDI exposure facility SHALL be reviewed by a Bioenvironmental Engineer or health physicist and approved by the Director of Base Medical Service (Air Force units will obtain approval through the Installation Radiation Safety Officer (IRSO)) prior to contract solicitation.

1.6.2.6 Before a new radiation exposure facility is placed in routine operation, the medical service SHALL be notified and a request submitted for a radiation protection survey by a qualified Bioenvironmental Engineer or health physicist.

1.6.2.7 Radiation exposure facility design SHALL show the cable passage between the exposure room and the controls outside this room. Cable passage SHALL be "S-shaped" and provide the same level of shielding as the X-ray barrier.

1.6.2.8 Provide appropriate ventilation in Rooms 2, 8 and 10 for radiographic film processing, penetrant, magnetic particle inspection and oil analysis processes.

WARNING

PVC piping SHALL not be used for stationary penetrant line plumbing. Penetrant oils and solvents attack many plastics which can cause deterioration and leaking. Ensure drain pipes are made from stainless steel or copper IAW MIL-PRF-32531.

1.6.2.9 Include all necessary provisions for handling waste materials (penetrants, silver recovery, etc.) containing pollutants in drainage system. One example, an oil/water separator, may be required to meet local EPA guidelines.

1.6.3 Electrical and Mechanical Requirements.

1.6.3.1 Due to the storage of temperature and humidity sensitive equipment and chemicals such as, X-ray film/Imaging Plates, chemical baths, and oil analysis; environmental controls SHALL be maintained throughout the entire NDI facility 24-hours per day, 7-days per week. The environmental controls SHALL be set to 70°F +/- 10°F and a relative humidity be less 60%.

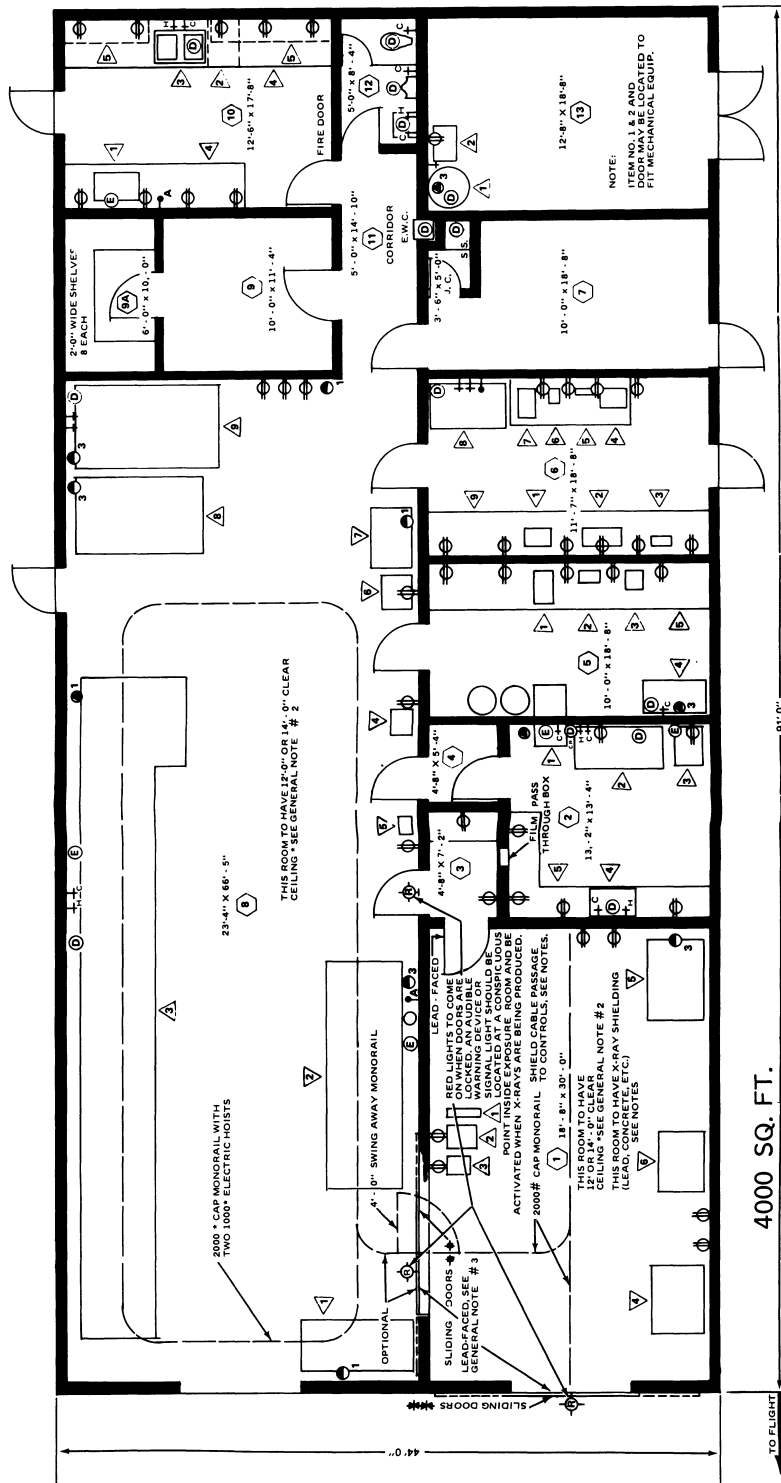
1.6.3.2 Recessed lighting fixtures MAY be used where operationally required; use surface mounted fixture when practical. Fixtures in Room 1 SHOULD be surface mounted if shielding is applied on ceiling.

1.6.4 Room Identification. The following is a list of typical rooms in the NDI laboratory:

- Room 1. X-ray vault
- Room 2. X-ray film processing room
- Room 3. X-ray control room
- Room 4. X-ray film processing room entrance
- Room 5. Computed Radiography image and/or film viewing room
- Room 6. Consolidated equipment room
- Room 7. Office
- Room 8. Main inspection bay
- Room 9. Training room
- Room 9a. Shop stock and storage
- Room 10. Oil Analysis lab
- Room 11. Corridor
- Room 12. Latrine
- Room 13. Mechanical equipment room

NOTE

Rooms 2 and 4 are not required at locations that do not perform the radiographic film technique and only have digital technique capabilities (e.g., computed radiography/digital detector array).



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Figure 1-5. Typical Nondestructive Inspection Facility

CHAPTER 2

LIQUID PENETRANT INSPECTION METHOD

SECTION I LIQUID PENETRANT (PT) INSPECTION METHOD

2.1 GENERAL CAPABILITIES OF LIQUID PENETRANT INSPECTION.

2.1.1 Introduction to Liquid Penetrant Inspection. Penetrant inspection is a method used to detect surface-breaking discontinuities (e.g., cracks, pits, etc.) in nonporous materials. This method utilizes a dye containing fluid which penetrates surface discontinuities through capillary action. The trapped penetrant increases the visibility of the discontinuity by providing a visual contrast between the discontinuity and the surrounding surface ([Figure 2-1](#)).

2.1.2 Background of Liquid Penetrant Inspection. Liquid penetrant inspection is one of the oldest nondestructive inspection methods. It was first used in the railroad maintenance shops in the late 1800s. Parts to be inspected were immersed in used machine oil. After a suitable immersion time, the parts were withdrawn from the oil and the excess surface oil wiped off with rags or wadding. The part surfaces would then be coated with powdered chalk or a mixture of chalk suspended in alcohol (whiting). Oil trapped in cracks or flaws would bleed-out causing a noticeable stain in the white chalk coating. This became known as the oil-and-whiting method.

2.1.2.1 The oil-and-whiting method was replaced by magnetic particle inspection on steel and ferrous parts in 1930. However, industries using non-ferromagnetic metals, especially aircraft manufacturers, needed a more reliable and sophisticated tool than discolored machine oil and chalk. In 1941, fluorescent dye materials were added to highly penetrating oil to make a penetrant material. Colored dyes, primarily red, were introduced a little later. Since then, a large number of penetrant systems or families have evolved. These include developments in various types and concentrations of dye materials, types of penetrating oils and additives, materials and methods for removing the excess surface penetrant, and various materials and forms of developing agents.

2.1.3 Why Use Liquid Penetrant Inspection. Penetrant inspection is an inexpensive and reliable nondestructive inspection method for detecting discontinuities open to the surface of the item to be inspected. It can be used on metals and other nonporous materials not harmed by penetrant materials. With the proper technique, it will detect a wide variety of discontinuities ranging in size from large, readily visible flaws down to the microscopic discontinuities, as long as the discontinuities are open to the surface and are sufficiently free of foreign material.

2.1.3.1 Penetrant is also used to detect leaks in containers. The same basic fundamentals apply, however, the penetrant removal step is typically omitted. The container is either filled with penetrant or the penetrant is applied to one side of the container wall. The developer is applied to the opposite side. After an appropriate dwell time, the developer coated side is inspected for evidence of penetrant leaking through the container wall. This method is most applicable on thin parts where access is available to both internal and external surfaces and the discontinuity is expected to extend through the material.

2.1.3.2 Due to its ability to inspect ferrous and nonferrous parts of all sizes and shapes, and its portability, the liquid penetrant NDI method can be used at both depot and field repair stations. For a specific aircraft type, a technical manual on nondestructive inspection is used to define the method, technique, equipment, component preparation, and precautions required to perform NDI on each component of the aircraft. A separate manual is used for engines.

2.1.3.3 With wider use of the eddy current NDI method, liquid penetrant is now becoming the secondary method for many applications. This is a result of the improved sensitivity of new eddy current inspection techniques and the fact that eddy current does not require use and disposal of potentially hazardous chemicals. For batch inspection of large areas, the penetrant method is still preferred due to the shorter total process time when compared to eddy current. In addition, penetrant is often used as a backup method for verification of defects found by eddy current inspection.

2.1.4 Limitations of Liquid Penetrant Inspection.

2.1.4.1 Restricted Flaw Openings. Penetrant inspection depends upon the ability of the penetrant to enter and exit the flaw opening. Any surface condition, such as coatings (e.g., paint, plating), dirt, oil, grease, or resin that interferes with the entry or exit, reduces the effectiveness of the inspection. Even when the coating does not cover the opening, the material at the edge of the opening may affect the entry or exit of the penetrant and greatly reduce the reliability of the inspection. Coatings at the edge of a discontinuity will also retain penetrant, causing background interference. An inspection method other than penetrant SHALL be used if the organic coating cannot be stripped or removed from the surface to be inspected.

2.1.4.2 Smeared Metal.

CAUTION

- Mechanical operations such as shot peening, plastic media blasting (PMB), machine honing, abrasive blasting, buffing, brushing, burnishing, grinding, and sanding will smear orpeen the surface of metals and close or reduce the surface opening of any existing discontinuities. Penetrant inspection may not reliably detect discontinuities when performed after a mechanical operation or service that smears or peens the surface. Any operation which results in surface material smearing or peening SHOULD NOT precede liquid penetrant inspection unless effective chemical etching is performed or unless specifically authorized by the cognizant engineering authority. Further discussion of mechanical working processes and surface preparation methods are provided further in this chapter.
- Once the part has been put back in service and has experienced normal service loads, it MAY be assumed any cracks closed by any of the above mechanical operations except shot peening will be reopened by the service loads and penetrant inspection MAY again be performed without etching. This mechanical working closes or reduces the surface opening of any existing discontinuities. Mechanical working (smearing or fretting) also occurs during service when parts contact or rub together.

2.1.4.3 Porous Surfaces. Penetrant inspection is impractical on porous materials, such as some types of anodized aluminum surfaces, and other protective coatings on other metals. The penetrant enters the pores of the material and becomes trapped. This can result in background that would reduce contrast or mask any potential discontinuity indications. In addition, removal of the penetrant may not be possible after the inspection.

2.1.5 Advantages of Liquid Penetrant Inspection.

NOTE

Although advantages and disadvantages may appear to be straightforward, the decision to select the penetrant test method or any other NDI method is often not obvious and depends upon a large number of factors. A thorough knowledge of the capabilities and limitations of all NDI methods is required. The decision on which method to use should be referred to the responsible NDI engineering activity.

- Liquid penetrant inspection is capable of examining all of the exterior surfaces of objects. Complex shapes can be immersed or sprayed with penetrant to provide complete surface coverage. Other nondestructive methods cover a specific area or location and must then be repeated to cover other areas or locations.
- Liquid penetrant inspection is capable of detecting very small surface discontinuities. It is one of the more sensitive nondestructive inspection methods for detecting surface flaws.
- Liquid penetrant inspection can be used on a wide variety of materials: ferrous and nonferrous metals and alloys, fired ceramics, powdered-metal products, glass, and some types of organic materials.
- Liquid penetrant inspection can be accomplished with relatively inexpensive, unsophisticated equipment. If the area to be inspected is small, the inspection can be accomplished with portable equipment.

- Through penetrant bleed-out, liquid penetrant inspection magnifies the apparent size of discontinuities resulting in a more visible indication. In addition, the discontinuity location, orientation, and approximate length are indicated on the part, making interpretation and evaluation possible.
- Liquid penetrant inspection is readily adapted to volume processing, permitting 100-percent inspection of all accessible surfaces. Small parts may be placed in baskets for batch processing. Specialized systems may be semi- or fully automated to process as many parts per hour as required.
- The sensitivity of a penetrant inspection process may be adjusted through selection of materials and techniques. This allows suppression of indications from small, inconsequential discontinuities while indicating larger discontinuities of concern.

2.1.6 Disadvantages of Liquid Penetrant Inspection.

WARNING

- Due to the oily nature of most penetrants, they SHALL NOT be used on parts such as assemblies where they cannot be completely removed and will subsequently come in contact with gaseous or liquid oxygen. Oils, even residual quantities, may explode or burn very rapidly in the presence of oxygen. Only materials specifically approved for this application SHALL be used if penetrant inspection is required and complete removal of the residue is not possible. Each application of these special oxygen-compatible materials SHALL be directed by the applicable technical order and/or upon direction by the responsible NDI engineering agency.
- Some penetrant materials may contain sulfur and/or halogen compounds (chlorides, fluorides, bromides, and iodides). These compounds may cause embrittlement or cracking of austenitic stainless steels if not completely removed prior to heat-treating or other high temperature exposure. Entrapped halogen compounds may also cause corrosion of titanium alloys if not completely removed after the inspection is completed and the part is subjected to elevated temperatures. Use of these materials SHALL be directed by the applicable technical order and/or upon direction by the responsible NDI engineering agency.
- Penetrant inspection depends upon the ability of the penetrating media to enter and fill discontinuities. Penetrant inspection will only reveal discontinuities open to the surface.
- The surfaces of objects to be inspected must be clean and free of organic or inorganic contaminants that will prevent the action of the penetrating media. It is also essential for the inside surface of the discontinuities be free of materials such as corrosion, combustion products, or other contaminants that would restrict the entry of penetrant.
- Penetrants are usually oily materials with strong solvent powers and highly concentrated dyes. They will attack some non-metallic materials such as rubber and plastics. There is also the possibility of permanent staining of porous or coated materials.

2.1.7 Basic Penetrant Inspection Process. A simplified description of the fundamental penetrant process steps is located in [Paragraph 2.4.2.1](#).

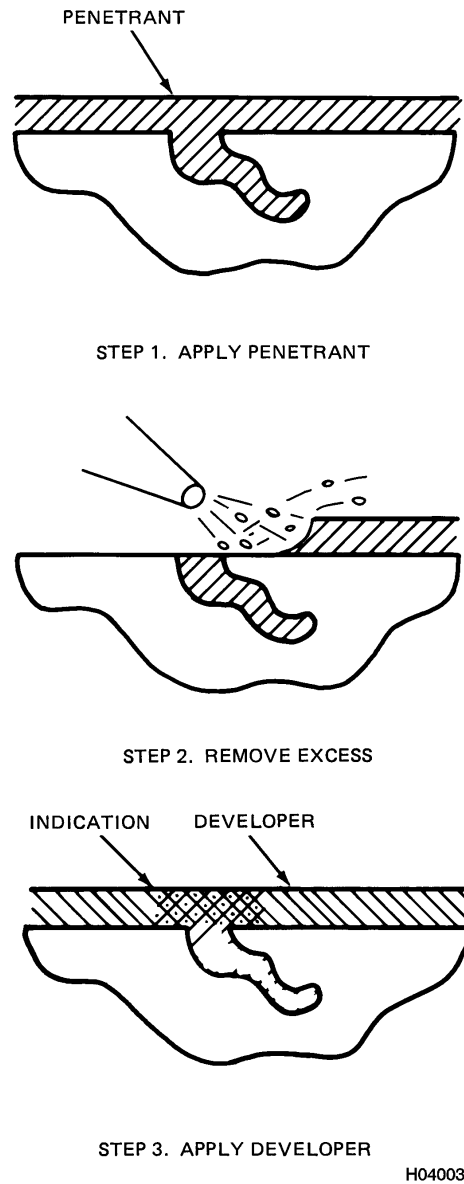


Figure 2-1. Basic Penetrant Inspection Process

2.1.8 Personnel Requirements.

NOTE

All individuals who apply penetrant materials or examine components for penetrant indications SHALL be qualified as specified in accordance with [Paragraph 1.2.](#)

The apparent simplicity of the penetrant inspection is deceptive. Very slight variations in the inspection process performance can result in reduced inspection sensitivity and failure to indicate serious flaws. It is essential for personnel performing penetrant inspection be trained and experienced in the penetrant process.

2.1.9 Understanding Penetrant Classification and Processes. This section defines the various classifications of penetrant testing materials and the general process steps of penetrant inspection. The information in this section is intended as introductory material for management, supervisors, and other personnel who are required to know the general applications

and classifications of penetrants, but do not require detailed NDI information. It can also be used in the training of beginning NDI personnel. We will review the various specifications, which define the penetrant material performance requirements and control the application of the penetrant process. Finally, we will also discuss the quality control and process testing requirements for penetrant materials. Detailed, technical information on penetrant materials and application processes is provided in subsequent sections.

2.1.9.1 Classification of Penetrant Materials and Processes.

2.1.9.1.1 SAE AMS 2644 Categories. The Aerospace Materials Specification SAE AMS 2644 defines the categories universally used for classifying penetrant inspection materials. The categories are defined as follows and are further defined in [Table 2-1](#).

- Type - Specifies the type of contrast dye used in the material.
- Method - Specifies the method used to remove the penetrant material.
- Level - Specifies the sensitivity level of a particular penetrant system.
- Form - Specifies the form (type) of developer being used.
- Class - Specifies the class of solvent remover to be used.

Table 2-1. Classification of Penetrant Materials Contained in SAE AMS 2644

Type	
Type I	Fluorescent Dye
Type II	Visible Dye
Method	
Method A	Water-Washable
Method B	Postemulsifiable, Lipophilic
Method C	Solvent Removable
Method D	Postemulsifiable, Hydrophilic
Sensitivity Level	
Level 1/2	Ultra Low
Level 1	Low
Level 2	Medium
Level 3	High
Level 4	Ultra High
Developer	
Form a	Dry-Powder
Form b	Water-Soluble
Form c	Water-Suspendible
Form d	Nonaqueous (Solvent based ; for Type I)
Form e	Nonaqueous (Solvent based ; for Type II)
Form f	Special Application
Solvent Remover	
Class 1	Halogenated
Class 2	Nonhalogenated
Class 3	Special Application

2.1.9.1.2 Penetrant Types.

2.1.9.1.2.1 Type I - Fluorescent Penetrant. Some chemical compounds have the capability of emitting visible light when exposed to near-ultraviolet radiation (UV-A, energy with a wavelength of 320 to 400 nanometers), commonly called UV-A or black light. This property is termed fluorescence ([Paragraph 2.2.3.2.2.6](#)). Type I penetrants are formulated with a dye that emit visible light when excited by UV-A radiation. Type I penetrants provide excellent detection sensitivity to small surface discontinuities as very small quantities of fluorescent penetrant will emit highly visible indications when exposed to UV-A.

2.1.9.1.2.2 Type II - Visible Penetrant.

CAUTION

DoD prohibits the use of visible penetrant on aircraft, engines, and missiles, except for those parts with specific engineering approval.

Visible-dye or color-contrast penetrants contain a red dye dissolved in the penetrating oil. The visibility is further enhanced during the penetrant process by the application of a layer of white developer. The white developer provides a high contrast background for the bright red penetrant when viewed under natural or white light.

2.1.9.1.3 Methods of Penetrant Removal. Penetrants are formulated and categorized by the specific removal method, not the material used to formulate it. The following are definitions of these methods:

2.1.9.1.3.1 Method "A" - Water Washable Penetrant.

CAUTION

The water washable (Method A) process is prohibited for use on all flight critical aircraft components and on all engine components. Water washable (Method A) processes SHALL NOT be used without specific written approval from the responsible engineering authority.

The usual liquid base or vehicle for a penetrant is petroleum oil, which is insoluble or immiscible in water. This means the penetrant cannot be removed with water, however, there are chemical compounds called emulsifiers that when mixed with the oil vehicle form a mixture that can be removed with water. The chemical compound forming the emulsifiable mixture is called an emulsifying agent or an emulsifier. Water-washable penetrants are formulated with an emulsifier as an integral component of the penetrant vehicle. This permits direct removal by water immediately after the penetrant dwell.

2.1.9.1.3.2 Method "B" - Postemulsifiable Lipophilic Penetrant.

CAUTION

Postemulsifiable Lipophilic (Method "B") penetrants are prohibited for use on critical rotating engine components.

Lipophilic is a word derived from the Greek words "lipo" for oil or fat, and "philos" meaning loving. Lipophilic emulsifiers are oil-based products, which are applied with the sole purpose to convert the excess surface penetrant into an emulsifiable mixture that can be removed with water. Method B penetrants are formulated to optimize their penetrating and visibility characteristics. They do not contain emulsifying agents and cannot be completely removed with water alone. Removal is made possible by applying an emulsifier in a separate process step.

2.1.9.1.3.3 Method "C" - Solvent Removable Penetrant.

WARNING

Solvents used may contain aromatic, aliphatic, or halogenated compounds. Aromatic compounds are characterized by a strange aroma and are formed from hydrocarbons and benzene. Aliphatic compounds are derived from fat; paraffin is an example. Halogenated compounds are materials in combination with the halogens, e.g. fluorine and/or chlorine. Many solvents are highly flammable while others may decompose at elevated temperatures. Keep all solvents away from heat and open flame. Vapors may be harmful, so use adequate ventilation. Avoid contact with skin and eyes. Do not take internally.

Method "C" is most often used with spray cans, but is also often brushed on to reduce the area coverage or to limit excess penetrant. The solvent removable method utilizes a solvent wipe to remove excess surface penetrant. Usually the penetrants used in the solvent removable process are the postemulsifiable penetrants; however, water washable penetrants can also be used. This method may be deceiving since all penetrants can be removed with solvents.

2.1.9.1.3.4 Method "D" - Postemulsifiable, Hydrophilic Penetrant. The word hydrophilic is derived from the Greek words "hydro" meaning water and "philos" meaning loving. The penetrants are often the same as those used in the lipophilic method; however, the hydrophilic emulsifier method requires the use of a separate water-based remover solution. Hydrophilic emulsifiers, also more accurately known as hydrophilic removers, are water-soluble and actually remove excess surface penetrant by means of a detergent action rather than an emulsification action. In this chapter, "remover" will be used when discussing hydrophilic material. This is the method generally used by the aerospace industry.

2.1.9.1.4 Levels of Penetrant Sensitivity. The following are the different levels of penetrant sensitivity you will see.

- Sensitivity Level 1/2 - Ultra-Low sensitivity
- Sensitivity Level 1 - Low sensitivity
- Sensitivity Level 2 - Medium sensitivity
- Sensitivity Level 3 - High sensitivity
- Sensitivity Level 4 - Ultra-high sensitivity

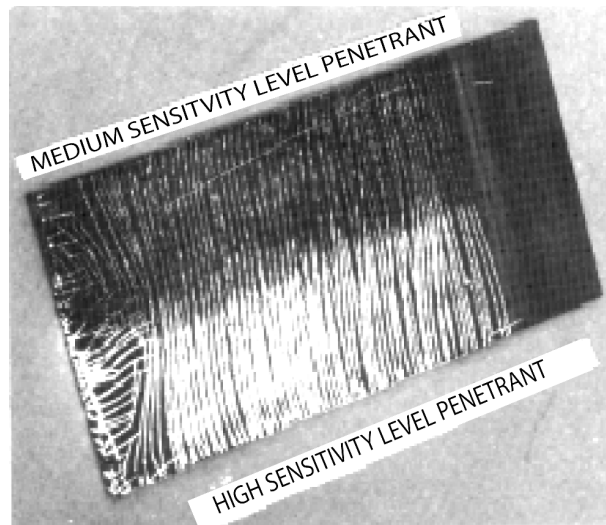


Figure 2-2. The Results of Inspection With a Medium Sensitivity Level Penetrant and a High Sensitivity Level Penetrant

2.1.9.1.5 Forms of Developer Application. The following are the developer forms you may see during penetrant inspection.

- Form a - Dry-powder
- Form b - Water-soluble
- Form c - Water Suspensible
- Form d - Nonaqueous, Type I, Fluorescent Systems (solvent based)
- Form e - Nonaqueous, Type II, Visible Dye Systems (solvent based)
- Form f - Special/Applications

2.1.9.1.5.1 Other Classification Documents for Developers. The Aerospace Materials Specification SAE AMS 2644 classifications are also referenced in latest version of the process standard ASTM E1417, Standard Practice for Liquid Penetrant Testing. The Type and Method classifications and the descriptions of the first four kinds of developers are referenced in ASTM E165, Standard Practice for Liquid Penetrant Testing for General Industry.

2.1.9.1.6 Classifications of Solvent Removers. The following are the classifications of solvent removers you may see during penetrant inspection.

- Class 1 - Halogenated
- Class 2 - Nonhalogenated
- Class 3 - Special Application

2.1.9.1.7 Developers, Solvents, and the Penetrant Family System Concept.

CAUTION

The penetrant family system concept does not permit penetrant inspection materials of different types or from different manufacturers to be mixed together. For example, a qualified nonhalogenated solvent remover from "manufacturer A" SHALL NOT be mixed with a qualified nonhalogenated solvent remover from "manufacturer B", and a qualified water-soluble developer from "manufacturer C" SHALL NOT be mixed with a qualified water-soluble developer from "manufacturer D".

A penetrant family system is defined as a penetrant and emulsifier together, from the same manufacturer. SAE AMS 2644 requires a penetrant/emulsifier combination be qualified and used together for both the lipophilic emulsifier and hydrophilic remover methods. For the water washable and solvent removable methods, the penetrant system consists of the penetrant alone. Solvent removers and developers are qualified independently and may be used with any qualified penetrant system. Therefore, a qualified post-emulsifiable penetrant system from one manufacturer may be used with any qualified developer; a qualified solvent removable system may be used with any qualified solvent and developer, and a qualified water washable penetrant system may be used with any qualified developer (approved for water washable systems). There may be a rare occasion where an incompatibility may exist between specific penetrant formulations and developer forms. The manufacturer's restrictions as well as any restrictions defined in SAE AMS 2644 SHALL be followed.

2.1.10 Qualification of Penetrant Material. The SAE AMS 2644 defines the penetrant material performance requirements and is used to procure penetrant materials. This document requires extensive testing on new penetrant material formulations. The test results and a sample of the material are then submitted to the qualifying agency. The qualifying agency reviews the reports and conducts additional tests to verify the acceptability of the material. If the candidate material(s) meets or exceeds the requirements of the specification, a letter of notification approving the material(s) for listing is issued and at the next revision, the material(s) and manufacturer are listed on the Qualified Products List (QPL) SAE AMS 2644. All materials listed in a given classification category are considered equivalent in meeting the generic specification requirements. Consequently, any manufacturer's penetrant system listed in the QPL, for a given type, sensitivity, and removal mode may be substituted for any other penetrant system listed to the same classification. QPL can be found on website http://quicksearch.dla.mil/qsDocDetails.aspx?ident_number=203153. Once connected search for 2644. Select QPL, then select "View QPL Data".

2.1.11 Qualification of Penetrant Sensitivity. The qualification test for penetrant sensitivity involves a comparison of the brightness of indications produced by a candidate penetrant system (penetrant and emulsifier) versus the indications produced by a penetrant system designated as a reference standard. The test panels for visible-dye penetrants are thermally cracked aluminum blocks. The test panels for fluorescent-dye penetrants are a series of titanium or nickel alloy panels containing various sizes of laboratory generated fatigue cracks. There is only one set of the latter qualification test panels, and it is not presently possible to produce duplicate fatigue cracks with identical penetrant performance characteristics. Therefore, non-qualification sensitivity comparison tests, which are not used for qualification purposes, may be accomplished with fatigue cracks or cracked-chrome plated panels.

2.1.12 Penetrant Material Performance.

2.1.12.1 Quality Conformance Testing of Penetrant Materials. Listing of materials on the QPL does not guarantee subsequent products of the same formulation will be acceptable. Listing on the QPL merely indicates the original raw materials, formulation, and compounding practice can result in an acceptable product. There are many factors and conditions involved in compounding and manufacturing penetrants that can affect their performance. QPL SAE AMS 2644 includes an option for a procuring activity to contractually require a manufacturer to provide quality conformance test results and a sample of the material from the lot or batch to be supplied. The procuring activity itself has the option of performing tests to verify the conformance of a material, whether a sample and test report is or is not contractually required.

2.1.12.2 Reporting of Nonconforming Materials.

NOTE

Knowledge of penetrant problems, even relatively minor ones, is essential for improvement of the NDI program, the materials specification, and the qualification tests.

Information copies of written correspondence concerning unsatisfactory penetrant materials SHALL be submitted to the Air Force NDI Office, AFLCMC/EZPT-NDIO, aflcmc-ezpt-ndio@us.af.mil; DSN 339- 4931; and AFRL/RXSA, Bldg.651, 2179 Twelfth Street, Wright-Patterson Air Force Base, OH 45433-7718. Unsatisfactory materials SHALL be reported in accordance with TO 00-35D-54 (Air Force) or AR 735-11-2 (Army). A copy of the quality conformance test results SHALL be included as substantiating data.

SECTION II PRINCIPLES AND THEORY OF LIQUID PENETRANT INSPECTION

2.2 PRINCIPLES AND THEORY OF LIQUID PENETRANT INSPECTION.

2.2.1 General. This section provides basic, operating, and advanced level information on the theory and mechanisms of penetrant action, and on the physical and chemical properties of penetrant materials. Also included is a discussion on their effects on the inspection process. In addition, a discussion of the mechanisms of penetrant removal and the development process are provided.

2.2.2 Characteristics of a Penetrant. There are a number of characteristics desired in a material for it to function as a penetrant. The four primary requirements are as follows:

- It SHALL be capable of entering and filling surface openings even though they may be very small.
- Penetrant in a discontinuity SHALL resist washing out during removal of the excess penetrant material on the surface of the part.
- It SHALL exit from the discontinuity after the surface penetrant has been removed.
- It SHALL present a readily visible or noticeable indication of the discontinuity on the part surface.

2.2.2.1 The primary requirements listed do not include the factors of being economical, safe, and practical to use. The primary requirements, combined with the additional factors, complicate the formulation of a penetrant material. The behavior of a penetrant is controlled by a number of physical and chemical properties, many of which are conflicting. As a result, commercial penetrants are a complex mixture of chemicals formulated for specific performance characteristics. Unfortunately, there is no simple rule for formulating a penetrant material, nor is there a set of characteristics which, if provided, will ensure a final material is completely satisfactory for all applications.

2.2.3 Mechanisms of Penetrant Action. To understand how penetrant works one must first understand the principles and properties associated with it. These are discussed in the following paragraphs.

2.2.3.1 Physical Principles. The penetrant inspection process requires a liquid that can flow over and wet a surface. The ability of a liquid to cover the surface of a part and enter any surface opening depends on 1) surface tension, 2) wetting ability, and 3) capillary action.

2.2.3.1.1 Surface Tension. Surface tension can be defined as the force required to expand (or pull apart) the surface of a liquid. The surface of a liquid exhibits certain features resembling the properties of a stretched elastic membrane. These features are due to the cohesive forces holding the surface molecules together, hence the term "surface tension". As an example, one may lay a needle or safety razor blade upon the surface of water and it will lie at rest in a shallow depression caused by its weight. The forces drawing surface molecules together can be strong. These forces, or surface tension, cause a droplet of liquid to have a spherical shape. A sphere has the smallest surface for a given volume of liquid. This has a direct effect upon the ability of a penetrant to wet a surface.

2.2.3.1.2 **Wetting Ability.** When a liquid comes into contact with a solid surface, the cohesive force responsible for surface tension competes with or is countered by the adhesive force between the liquid molecules and the solid surface. These forces determine the contact angle the liquid forms with the surface. The contact angle is the measured angle a drop of liquid makes with a solid surface. If the contact angle is zero the liquid will “wet” and spread. If the contact angle is 90-degrees or more the liquid will not “wet” the surface and will remain as a rounded drop. Intermediate contact angles indicate intermediate degrees of wetting. Three examples of contact angle are illustrated (Figure 2-3). The Greek letter θ “theta” designates contact angle.

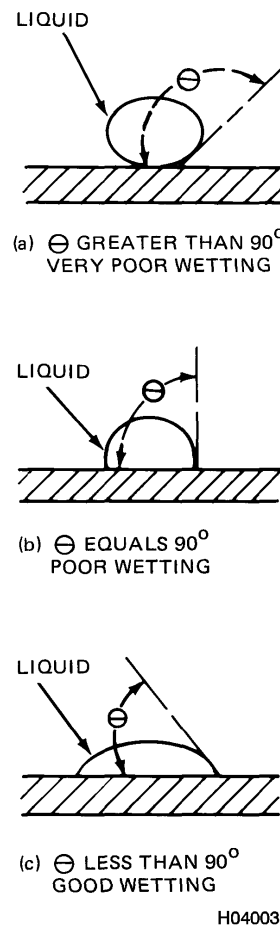


Figure 2-3. The Contact Angle, θ , is the Angle Between the Liquid and Solid Surface and is a Measure of the Wetting Ability

2.2.3.1.3 **Capillary Action.** Capillary action is defined as the tendency for a liquid to penetrate or migrate into small openings, such as cracks, pits, or fissures. Capillary action is associated with wetting ability. For example, when a tube with a small inside diameter is inserted into a liquid, the liquid level inside the tubing may rise above, remain even, or be lower than the outside liquid level. If the contact angle between the liquid and the tubing wall is less than 90-degrees (the liquid wets the tube wall), the liquid will be higher in the tube than on the outside. When the contact angle is 90-degrees or greater (poor wetting and high surface tension), the liquid will not rise above the outside level and may even be depressed. Capillary rise occurs when a liquid wets the inside of a tube and the surface tension draws additional liquid into the wetted area. The effects of contact angles and capillary action are illustrated (Figure 2-4).

2.2.3.2 **Penetrant Properties.** Surface tension and wetting action are only two requirements of a penetrant. In addition to penetrating ability, a satisfactory penetrant must resist removal from discontinuities when excess surface penetrant is removed from the surface, produce a noticeable indication, and be practical and economical to use. Formulation, selection, and

application of penetrant materials requires consideration of many physical and chemical properties. Some of these properties, other than surface tension and wetting ability, are discussed in the following paragraphs.

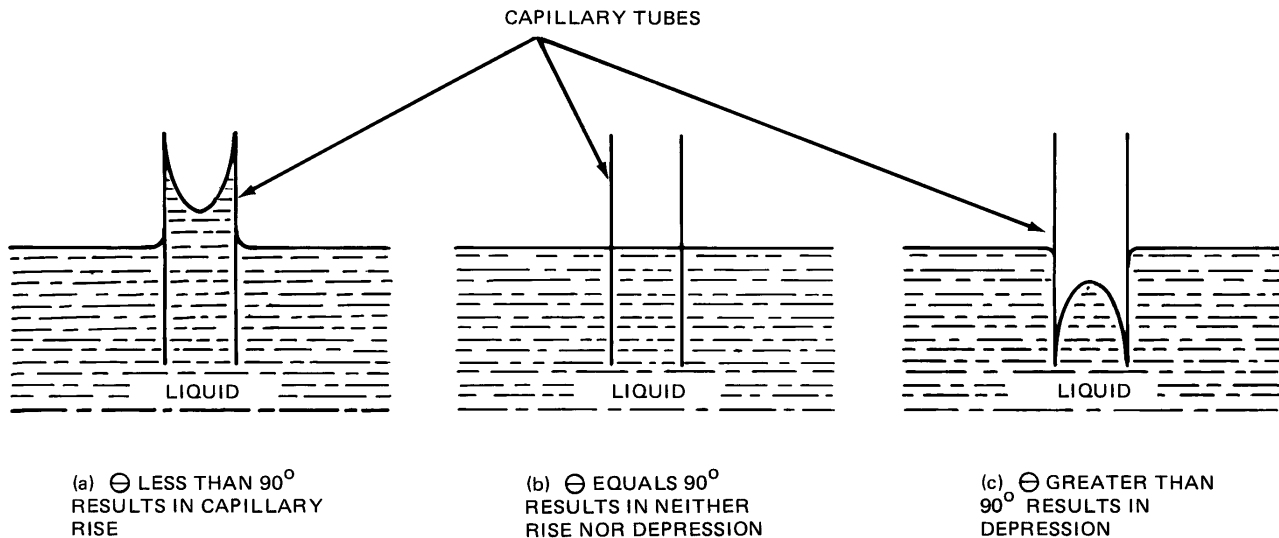


Figure 2-4. The Rise and Depression of Liquid in a Capillary Tube is Dependant Upon the Contact Angle

2.2.3.2.1 Physical Properties.

2.2.3.2.1.1 Viscosity. Viscosity is a measure of a liquid's resistance to a change in physical shape and is related to internal friction. The viscosity of a liquid decreases as the temperature is raised and viscosity increases as the temperature is lowered. Viscosity has no effect on penetrating ability. Some highly viscous fluids, such as molasses, have very good penetrating ability, while some low viscosity liquids, such as pure water, have very poor penetrating ability. However, from an application viewpoint, viscosity affects the speed with which a penetrant enters a discontinuity. Viscosity also determines how much penetrant will remain on a part surface during the dwell period. High viscosity penetrants cling to the surface, requiring increased effort for removal. Very thin penetrants (low viscosity) may drain from the part surface so quickly insufficient penetrant remains to enter into discontinuities.

2.2.3.2.1.2 Specific Gravity. Specific gravity is the ratio of the density of a substance to the density of distilled water usually measured at 60°F (15.6°C). This is also the ratio of the weight of the substance to an equal volume of water. Specific gravity has no direct effect on the performance of a penetrant. Most commercial penetrants have a specific gravity of less than one, primarily because they are made up of organic materials having low specific gravities. For this reason, water contamination sinks to the bottom of the penetrant tank.

2.2.3.2.1.3 Flash Point. Flash point is the lowest temperature at which vapors of a substance ignite in air when exposed to a flame. The flash point does not affect the performance of a penetrant. High flash points are desirable to reduce the hazard of fire. Penetrants and lipophilic emulsifiers meeting the requirements of SAE AMS 2644 have a minimum flash point of 200°F (93°C) if they are to be used in open tanks.

2.2.3.2.1.4 Volatility. The vapor pressure or boiling point of a liquid characterizes its volatility. It is associated with the evaporation rate of liquids and is desirable for penetrant materials to have a low volatility, i.e., a high boiling point. However, in the case of petroleum products, viscosity increases as the boiling point goes up. In this group of materials, the lower viscosity is preferred because they require less penetrating time. Still, for practical purposes, high volatility should be avoided before viscosity becomes a problem. High volatility results in a loss of penetrant in open tanks and can result in penetrant drying on a part during the penetrant dwell, leaving a film difficult to remove. Entrapped, highly volatile penetrant would also have a

tendency to dry or lose its liquid properties, resulting in failure to bleed back out of a discontinuity and to produce an indication. In general, low volatility provides four advantages:

- Low economic loss due to low evaporation loss.
- Low fire hazard because few flammable vapors form above the liquid.
- Low toxicity because of low hazardous vapor concentrations in the test area.
- Uniform removal and fluorescent properties because of minimal evaporation.

2.2.3.2.1.5 Fluorescent Dye Thermal Stability. The dyes used in fluorescent-dye penetrants lose their brightness or color when subjected to elevated temperature. Loss of brightness or color also occurs at moderate temperatures, but at a slower rate. This loss is termed "heat fade". SAE AMS 2644 specifies the maximum allowable brightness loss (heat fade) as a function of penetrant sensitivity. This test is performed after a penetrant has been subjected to an elevated temperature. Thermal stability is an important consideration during hot air drying before or after developer application.

2.2.3.2.1.6 Water Washable Penetrant Thermal Stability. Thermal stability is the ability of water washable penetrants to resist physical changes under normal operating (temperature) conditions. SAE AMS 2644 requires water washable penetrants submitted for qualification to be thermally cycled between 0°F and 150°F for 8-hours without separation or major degradation in performance.

2.2.3.2.1.7 Storage Temperature Stability.

NOTE

Penetrant materials, excluding dry developer, SHALL NOT be stored in direct sunlight or at temperatures above 130°F (55°C) or below 32°F (0°C).

Storage temperature stability is the ability of a penetrant to resist physical and chemical changes when stored in sealed containers within a controlled environment (i.e. typical room temperature). SAE AMS 2644 requires penetrants to resist physical changes including settling, or gelling after a 1 year storage period. Most liquid penetrant materials are not greatly affected over time as long as they are kept in closed storage containers.

2.2.3.2.2 Chemical Properties.

2.2.3.2.2.1 Chemical Inertness.

CAUTION

Penetrant materials MAY cause deterioration and damage to materials that react to hydrocarbons. Penetrant materials SHALL NOT react with the materials to be inspected.

It is necessary that the penetrant, emulsifier, and developer material be chemically inert relative to the parts being inspected. Most oil based materials meet this requirement; however, water contamination of many oils may cause the mixture to become alkaline. This is one of the reasons why water contamination must be avoided. While oily penetrant materials are generally inert to most metals, there is no one material that can be formulated for all parts. Chemical reactivity of penetrant materials must be considered whenever a new application is encountered. Some rubber (natural and synthetic) and plastic (transparent and opaque) parts are susceptible to attack by the solvents and oils in the penetrant materials. Some metals can be degraded at elevated temperatures by the trace amounts of sulfur or chlorine in conventional penetrants. Special low sulfur and low chlorine materials are available and are discussed in [Paragraph 2.7.3](#).

2.2.3.2.2.2 Toxicity. Toxicity is the measure of adverse effects on humans resulting from contact with the material. It applies to any abnormal effects ranging from nausea and dermatitis through dysfunction of major organs, such as the liver or kidneys. It is essential for penetrant materials to be nontoxic. In qualifying penetrant materials for the QPL, the manufacturer must submit a certified statement identifying each ingredient in the product by a recognizable chemical or trade name.

2.2.3.2.2.3 Solvent Ability. The visibility of indications depends upon the fluorescent or visible dye dissolved in the penetrant oils. The oils used in penetrants must have good solvent properties to dissolve and hold the dye in solution. It must maintain the dye in solution under the wide range of temperatures encountered during transit and storage of the penetrant. If even a small amount of separation occurs, recombination may be very difficult or impossible, resulting in decreased penetrant performance.

2.2.3.2.2.4 Removability. This term describes two conflicting requirements for a penetrant: a) the ability to be removed from a surface leaving little or no residual background and b) resistance to being removed from discontinuities. In order to meet the first requirement, the penetrant must maintain the dyes in solution even when in the form of a thin film on the surface of a part and without its more volatile components lost during the dwell time. This is more difficult for water washable penetrants than postemulsifiable penetrants because the water washable penetrant does not receive the additional solvent or surfactant of the emulsifier/remover during the removal process. For water washable penetrants and postemulsifiable penetrants used with a lipophilic emulsifier, the penetrant resists removal by the formation of a gel with the penetrant/water mixture during washing that protects the penetrant in discontinuities from removal. For postemulsifiable penetrants used with a hydrophilic remover (Method D), the resistance to removal is due to the lack of diffusion of the surfactants into the surface penetrant layer, thus making only the thin surface layer emulsifiable and not the penetrant in discontinuities beneath the layer. When using solvent removable penetrants the same effect can be achieved by minimizing the amount of solvent used during the removal process.

2.2.3.2.2.5 Water Tolerance. When penetrants are used in open tanks some water contamination is inevitable. Postemulsifiable penetrants are inherently tolerant to water intrusion. Since they are oil based materials, any extraneous water will settle to the bottom of the tank. Although their performance is not degraded, corrosion of the tank can occur. However, water washable penetrants contain emulsifiers and will combine with water. They can tolerate the addition of small amounts of water without losing their properties. The penetrant material procurement specification, SAE AMS 2644, requires Method A penetrants to tolerate the addition of 5-percent of water, based on volume, without gelling, separating, clouding, coagulating, or floating of water on the surface.

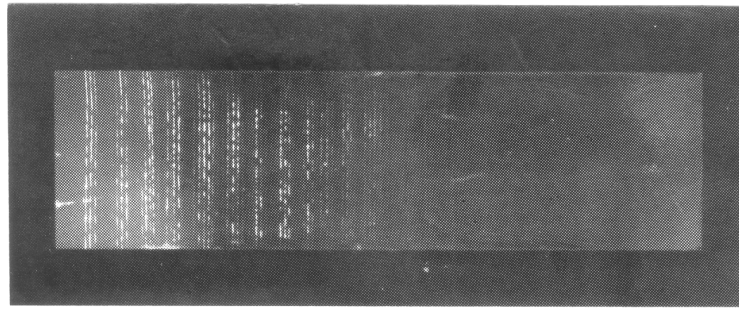
2.2.3.2.2.6 Mechanism of Fluorescence. The mechanism of fluorescence involves two factors: the atomic structure of the fluorescent material and the energy level or wavelength of the radiation source. The basic component of all matter is the atom that consists of protons, neutrons, and electrons. The protons and neutrons form a positively charged nucleus or core, while the negatively charged electrons circulate in orbits around the nucleus. The orbits are actually shells or rings of discrete energy levels with a definite number of electrons in each shell. A material will fluoresce only if it has a certain atomic structure: 1) the energy holding the electrons in orbit in the outer shells must be low, and 2) there must be vacant electron space in the outermost shell. When a photon of electromagnetic radiation from an X-ray or ultraviolet light impacts an electron in an atom of fluorescent material, the electron absorbs some of the photon energy and jumps from its natural shell to a higher energy shell. The electron is unstable in this condition and immediately returns to its natural shell or orbit. In returning to equilibrium, the electron releases its excess energy as electromagnetic radiation. The released electromagnetic energy always has a longer wavelength than the exciting radiation. Thus, ultraviolet radiation with a wavelength of 365 nm (nanometer, a unit of length) causes some fluorescing materials to release energy that has a longer wavelength of 400 to 700 nm. This is the wavelength range of visible light. The human eye is most sensitive to yellow-green light at approximately 510-560 nm in darkness. Most dyes are formulated to emit this range.

2.2.3.2.2.7 Brightness. One of the more important factors responsible for the effectiveness of the penetrant process is the visibility of the indication. Penetrants containing fluorescent dyes are not especially visible under white light. However, when subjected to near ultraviolet (365 nm) radiation (UV-A), the dyes emit visible light. Some dyes emit more visible light per unit of ultraviolet energy than others. In addition, the amount of light given off is proportional to the amount of dye in the penetrant. Brightness is a measure of the amount of visible light given off when fluorescent dye is exposed to ultraviolet radiation. It is controlled by the particular dye's efficiency in converting ultraviolet radiation into visible light and by the quantity of dye dissolved in the penetrant. High efficiency dyes are brighter than low efficiency dyes when exposed to the same wavelength and intensity of ultraviolet radiation.

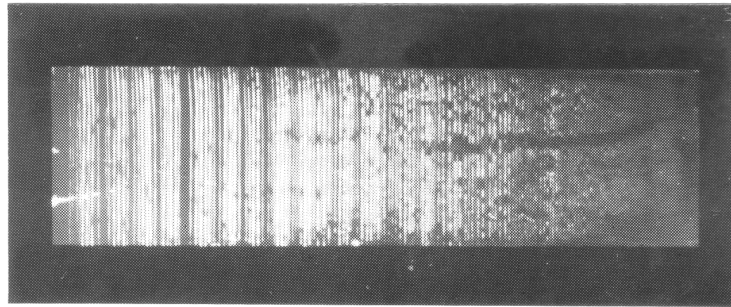
2.2.3.2.2.8 Ultraviolet Stability. Fluorescent dyes lose their ability to fluoresce after prolonged exposure to ultraviolet radiation. Resistance to this loss is termed ultraviolet stability. SAE AMS 2644 requires a diluted sample of fluorescent penetrant to retain a minimum brightness, after a 1 hour exposure to 800 $\mu\text{W}/\text{cm}^2$ (micro-watts per square centimeter) of ultraviolet (UV-A) exposure.

2.2.3.2.2.9 Penetrant Sensitivity. The term "sensitivity", when used to describe a penetrant performance characteristic, is the ability to produce indications from very small, tight cracks. This characteristic involves the combined properties of pen-

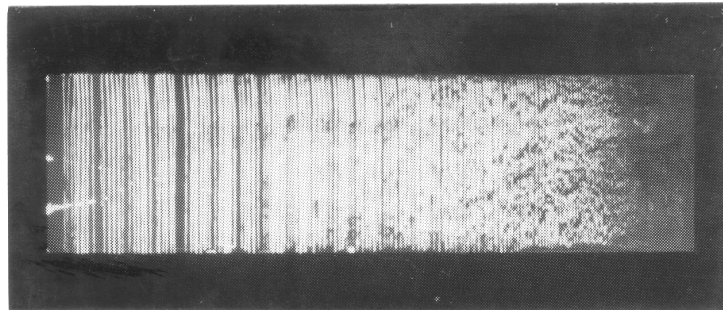
etrating ability and brightness. The flaw opening in discontinuities is usually restricted, and the void volume is such that only a very small amount of penetrant can be entrapped. The penetrant must enter and exit the flaw with enough dye to produce a noticeable indication.



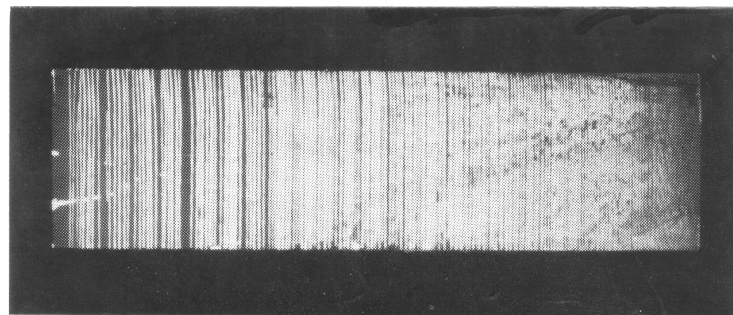
LEVEL 1



LEVEL 2



LEVEL 3



LEVEL 4

Figure 2-5. Indications Produced by Penetrant of Four Different Sensitivity Levels Using Dry Developer

2.2.4 How Liquid Penetrant Enters Discontinuities. If one end of a capillary tube is closed, such as occurs in the case of a flaw, the capillary rise is affected by compression of the air trapped in the closed end. The phenomenon of capillary action enables penetrant to enter a flaw, even in an inverted position, such as on a lower wing surface. However, flaws are not capillary tubes as the sides are not parallel and are not circular. The ability of penetrant to successfully enter and exit discontinuities is dependent on a number of factors. The points to remember about penetrant entry into discontinuities are as follows:

- A high surface tension and small contact angle are desirable in a penetrant, however these are conflicting properties. High surface tension tends to increase contact angle and decrease wetting ability, but enhances drawing penetrant into wetted areas.
- Capillary force increases with smaller flaws.
- Viscosity does not affect the penetrating ability but it can affect the time required for penetration.
- Shape of a discontinuity can affect penetrant entry.
- Temperature affects the surface tension.
- Roughness of the flaw walls will impede penetrant entry.
- Contamination in the flaw can impede penetrant entry.
- Residual cleaning solution in the flaw can impede penetrant entry.

2.2.5 Mechanisms and Principles of Penetrant Removal.

2.2.5.1 Mechanisms of Method "A" Water Washable Penetrant Removal. Water washable penetrants contain an emulsifying agent. Following the penetrant dwell time excess Method A penetrants are removed with a water spray. The water washable penetrant is converted into small, suspended oil droplets by the mechanical force of the water spray. A separate process step of applying emulsifier is not required. Water washable penetrants are often called "self-emulsifying" and are one of the most widely used NDI methods. Water washable penetrants exist in all penetrant system sensitivity levels.

2.2.5.1.1 Method "A" Emulsification. Generally, oil and water do not mix; however, this is not always the case. If equal amounts of oil and water are placed in a bottle, they will immediately separate into two distinct layers. If the bottle is shaken, the oil will form into globules, which are dispersed throughout the mixture. When the bottle is allowed to rest, the globules will rise to the surface and reform into a separate oil layer. The process of the globules combining to form this layer is called coalescence. If the amount of oil is small compared to the quantity of water, and the bottle is violently shaken, the oil will be separated into very small droplets. On standing, most of the droplets will coalesce at a slower rate than previously described. However, some of the very small droplets will remain suspended in the water giving it a cloudy or milky appearance. Depending on the droplet size, it may require an extremely long time for separation to take place. This cloudy water mixture is called a colloidal suspension and the process by which it is formed is termed emulsification. Certain chemicals have the ability to combine with oily materials to form an easily emulsifiable mixture. This is the case when an emulsifier is applied to a penetrant on a part. The penetrant is oil that repels water and resists removal. However, when combined with an emulsifier, the resulting colloidal mixture can be removed with a water spray.

2.2.5.2 Mechanisms of Method "B" and Method "D" Penetrant Removal.

2.2.5.2.1 Lipophilic Emulsifier (Method "B") Mechanism and Modes of Action. The lipophilic emulsifier has two primary modes of penetrant removal, chemical diffusion, and draining. These processes are described as follows:

2.2.5.2.1.1 Mode 1 - Chemical Diffusion. For lipophilic emulsifiers, diffusion into the oil-base penetrant is the primary mode of action. Diffusion is the intermingling of molecules or other particles as a result of their random thermal motion. If two miscible (capable of being mixed) liquids or gases are placed in a container, they will eventually mix into a uniform solution. For example, if a sugar solution (a heavy solution) is placed in the bottom of a glass, and plain water (lighter medium) is placed on top, the sugar will migrate across the boundary. After a period of time, the entire quantity of liquid will reach a nearly uniform concentration. This is what happens when emulsifier (Method B) is applied to a layer of penetrant on a part ([Figure 2-6](#)).

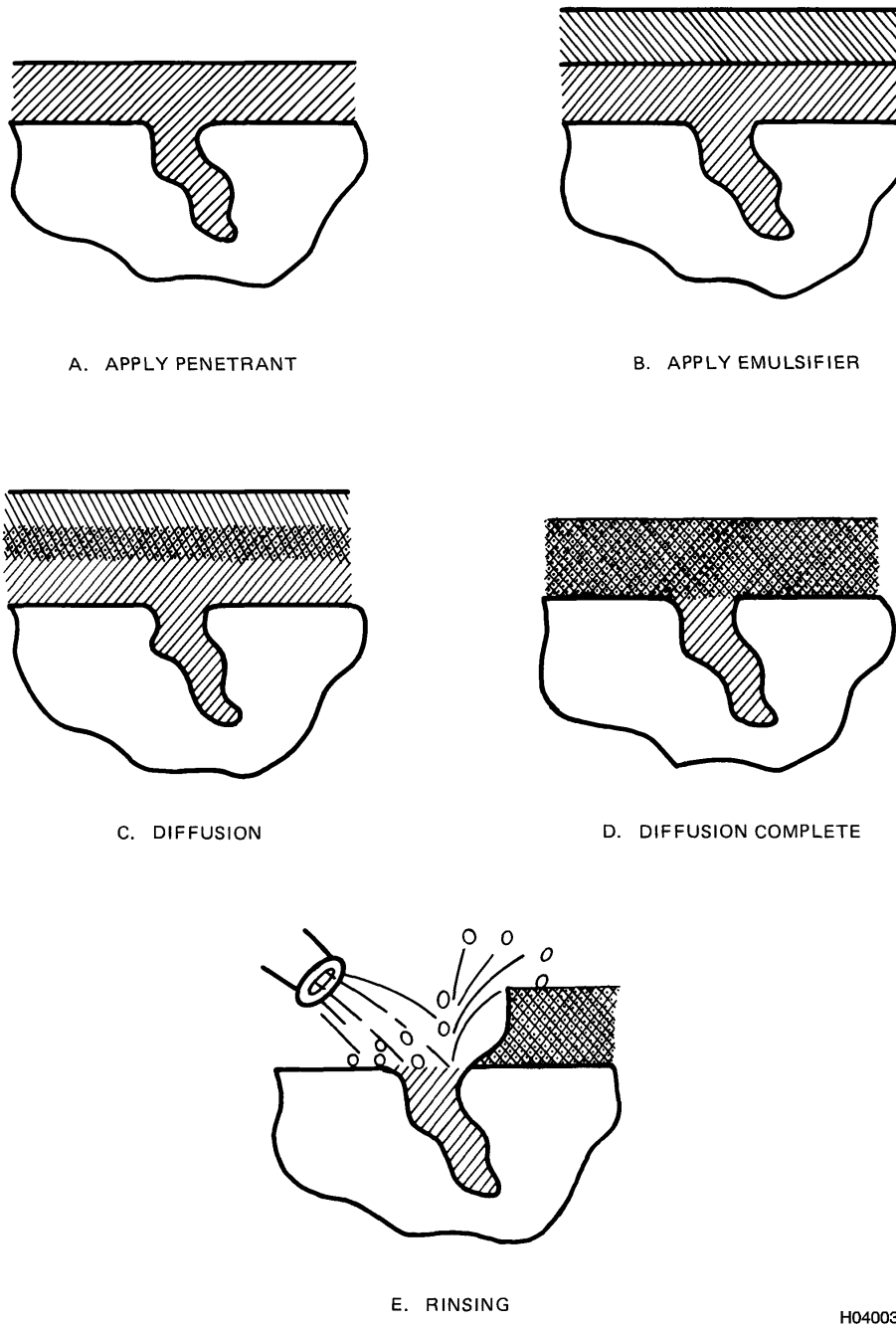


Figure 2-6. Diffusion of Emulsifier Into Penetrant During Lipophilic Emulsifier Dwell

2.2.5.2.1.2 Mode 2 - Drain and Dwell.

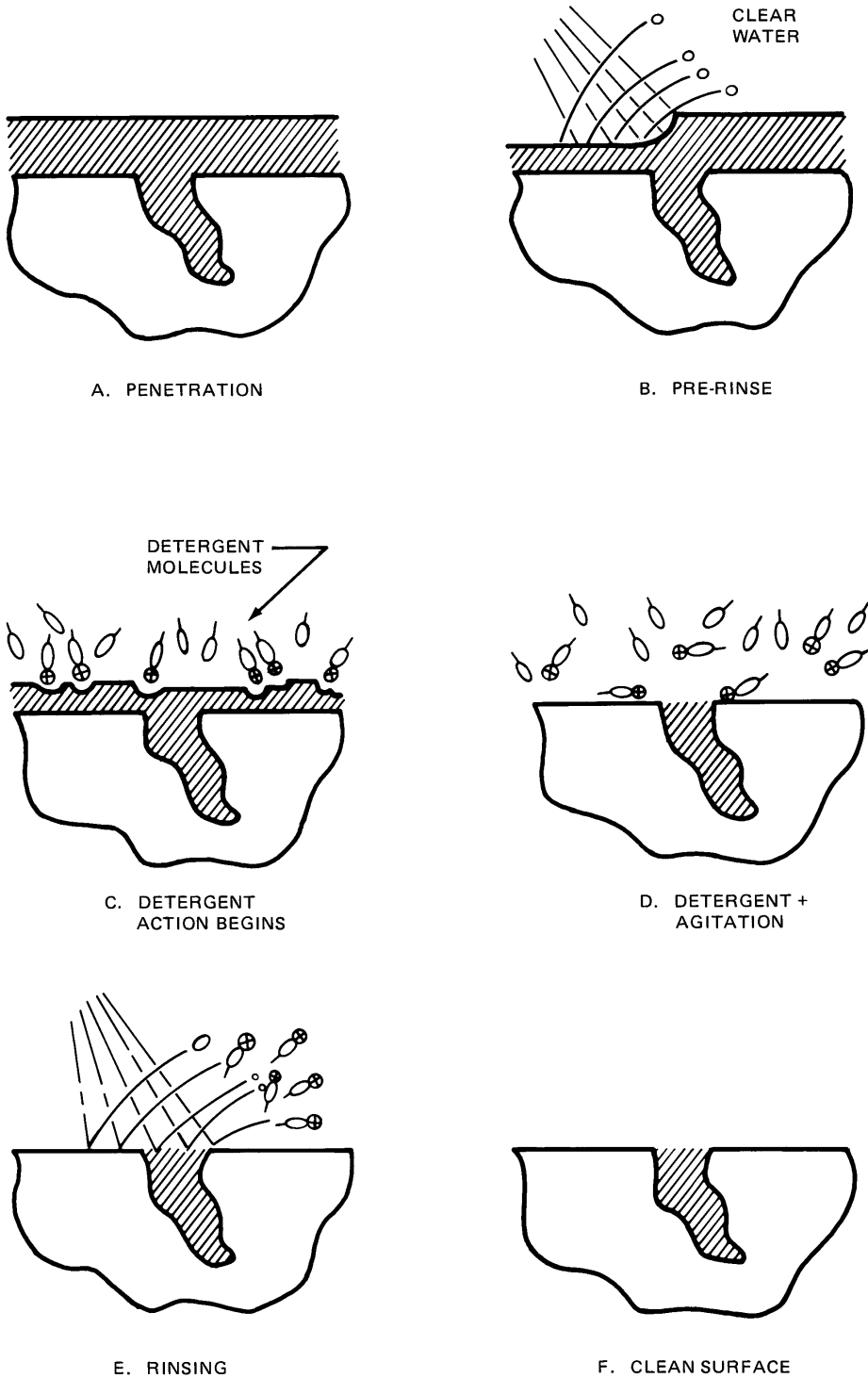
NOTE

Parts SHALL NOT remain in the emulsifier and care SHALL be exercised to prevent pooling in cavities during the dwell.

It was once thought emulsification occurred only through the chemical action of diffusion. It should be recognized a second mode of emulsification is also involved. This mode occurs as the emulsifier drains from the part surface during the dwell

period. As the emulsifier drains, the movement carries with it considerable surface penetrant. This scrubbing or mechanical action reduces the amount of penetrant to be emulsified and also initiates the chemical or diffusion action. Without this mixing action, emulsifier dwell time might be as long as ten or twenty minutes. It is for this reason parts SHALL NOT be left in the emulsifier and care SHALL be exercised to prevent pooling in cavities during the dwell.

2.2.5.2.2 Hydrophilic Remover (Method "D") Mechanism and Mode of Action. Hydrophilic removers are basically detergent/dispersing concentrates consisting of water-soluble chemicals, usually non-ionic surface-active agents called surfactants. They are supplied as concentrated liquids and are mixed with water either before or during the removal process. The surface-active agent in the remover displaces a small quantity of penetrant from the surface and disperses or dissolves it, preventing it from recombining with the remaining penetrant layer. Unlike lipophilic emulsifier, hydrophilic remover is immiscible with penetrant and diffusion does not occur. All of the removal action takes place at the exposed surface, and penetrant just below the surface is not involved until it becomes exposed. Gentle agitation of the liquid helps remove the displaced penetrant and allows fresh remover to contact the remaining penetrant layer. The action stops when the part is withdrawn from the remover. This process is significantly different from lipophilic emulsifiers that become active after withdrawal and during drainage. Hydrophilic remover action is illustrated ([Figure 2-7](#)).



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Figure 2-7. Action of the Hydrophilic Remover Process

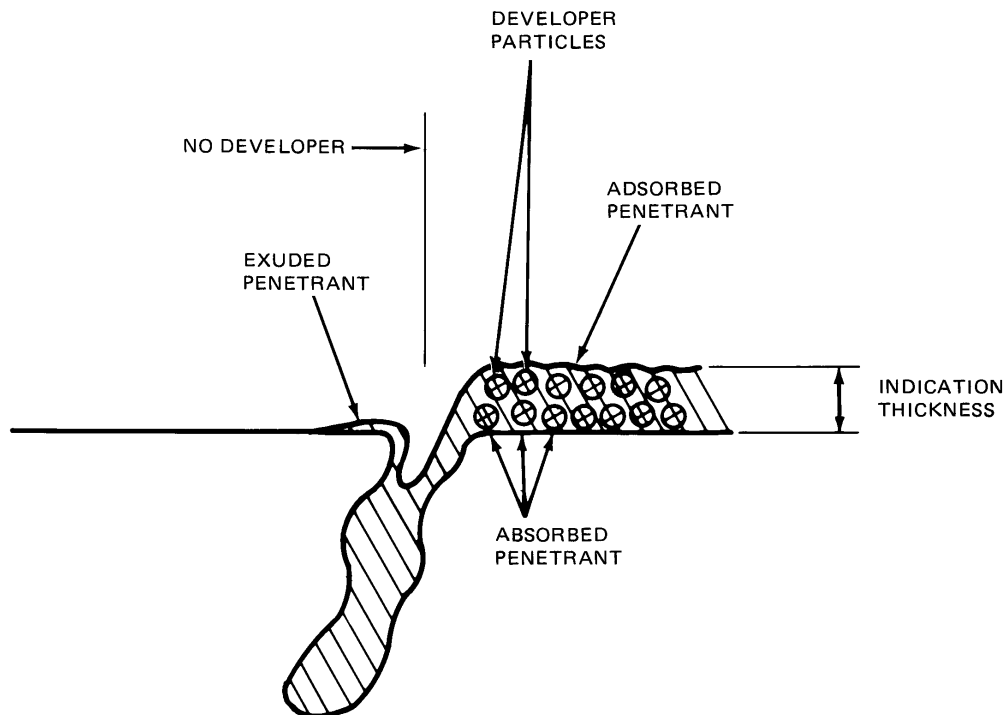
2.2.5.2.3 Solvent Removable (Method "C") Mechanism and Mode of Action. The solvent-wipe method for removal of excess surface penetrant relies on a combination of dilution and mechanical action. Solvent removers are formulated to dissolve and dilute surface penetrant to enable effective absorption and removal by wiping the surface with a solvent dampened rag or towel. Desirable properties are low toxicity, solvency for liquid penetrant, and a compromise between maximum drying speed and minimum fire hazard.

2.2.6 Mechanisms of Developer Action.

2.2.6.1 Functions of a Developer. The basic function of all developers is to improve the visibility of the entrapped penetrant indication. The improvement in visibility is achieved through a number of mechanisms including the following:

- Assist in extracting the entrapped penetrant from discontinuities.
- Spread or disperse the extracted penetrant laterally on the surface, thus increasing the apparent size of the indication.
- Improve the contrast between the indication and the background.

2.2.6.1.1 Adsorption and Absorption. The mechanism of development is a combination of both adsorption and absorption (Figure 2-8). Adsorption refers to the collection of a liquid on the outer surface of a particle due to adhesive forces. This action contributes to the developer particle build-up at a crack as the particles adhere to the exuded penetrant. Absorption refers to the blotting action that occurs when a liquid merges into an absorbent particle.



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Figure 2-8. The Effects of a Developer

2.2.6.1.2 Contrast Enhancement. Developers improve the visibility of indications by providing a contrasting background. They reduce reflections from a part surface and appear blue-black under UV-A illumination. The blue-black background provides a high contrast with the fluorescent yellow-green penetrant indication. Water-suspended and some nonaqueous developers produce a solid white coating, which provides a contrasting background for red visible-dye penetrant.

2.2.6.1.3 Solvent Action. Nonaqueous developers contain solvents that hold the developer particles in suspension. When sprayed on the part, the solvent combines with any entrapped penetrant, diluting it. This increases the volume and reduces the viscosity of penetrant that exudes from the discontinuity, thus improving the visibility of the indication. Nonaqueous developers are capable of providing the highest sensitivity of any of the developer forms.

2.2.6.1.4 Scattering of Light. The developer particles scatter both the incoming ultraviolet light and the exiting visible light. This property enhances the brightness of a fluorescent indication by causing more of the ultraviolet light to be absorbed by the penetrant and more of the visible (fluorescent) light to escape the penetrant layer and reach the inspector's eye.

2.2.7 Cleaning and Surface Preparation.

2.2.7.1 Responsibility for Cleaning and Surface Preparation.



CAUTION

Due to the various and potentially catastrophic effects various surface preparation processes may have on different materials, only properly trained personnel SHALL accomplish surface preparation processes. This training SHALL be documented in personnel training records. Nondestructive inspection personnel are neither trained nor experienced in performing paint stripping or cleaning.

Properly performing surface treatment operations, such as paint stripping and cleaning of military system metals and alloys, require skill and knowledge. Improper methods, materials, or procedures can result in severe damage to surfaces and parts.

2.2.7.2 Need for Clean Surfaces. The proper preparation of parts prior to inspection is critical. Successful detection of discontinuities by penetrant inspection depends upon the ability of the penetrant to enter and exit from the discontinuity. The resulting indication must be readily distinguishable from the background. Surface conditions, such as coatings or soil contamination, can reduce the effectiveness of the inspection by interfering with the entry and exit process or producing a high residual background. Penetrant inspection is reliable only when the parts to be inspected are free of contaminants. Foreign material, either on the surface or within the discontinuity, can produce erroneous results. Proper cleaning or surface treatment prior to penetrant application must remove any interfering conditions.

2.2.8 Surface Conditions Affecting Penetrant Inspection. There are three general categories of surface condition that have detrimental effects on penetrant inspection. These conditions are classified as contaminants/soils, coatings, and surface deformation. Each of these conditions can negatively affect penetrant inspection and must be corrected before penetrant inspection can be properly performed. The following sections provide a discussion of each category and highlight the methods used to correct these conditions.

2.2.9 Contaminants and Soils. In this section, the terms "contaminants" and "soils" are used interchangeably and refer to matter on a part or component that may affect the penetrant testing process. Contaminants may be intentionally applied, such as greases or corrosion prevention compounds, which may result from prior processes, such as heat-treating, or cleaning, or may be the consequence of service, e.g., corrosion, carbon deposits, lubricating fluids, or dirt particles. The effects of contaminants on the penetrant inspection process depend on the type of soil and whether it is on the part surface or entrapped in a discontinuity.

2.2.9.1 Contamination/Soil Removal - Factors in Selecting a Cleaning Process.

CAUTION

- Improper cleaning methods can cause severe damage or degradation of parts. Only properly trained/qualified personnel SHALL select or apply cleaning processes. This training SHALL be documented in personnel training records.
- The success of any penetrant inspection procedure depends upon the cleanliness of the part surface and discontinuities being free of any contaminants or soils. There are a variety of cleaning methods which may be utilized. The methods are generic and are used principally for corrosion prevention and preparation of items for surface treatments. The most common cleaning methods are discussed in the following paragraphs.

2.2.9.1.1 Cleaning is a broad term covering methods and materials used to remove contaminants or soils from a surface. Cleaning is routinely used for corrosion control and to prepare surfaces for other treatments. There are no special methods or materials specifically dedicated to penetrant inspection. Different materials and parts require separate or individual cleaning processes. No one cleaning method is equally effective on all contaminants. The selection of a suitable cleaning process is complex and depends on a number of factors, such as:

- Type of soil(s) or contaminant(s) to be removed.
- Part material - Strong alkaline or acid cleaners can attack some nonferrous metals, e.g., aluminum and magnesium. Steels, especially in the heat-treated condition, are likely to become embrittled by acid cleaners. Cleaning compounds containing halogen and sulfur compounds can attack other metals, e.g., titanium and high nickel alloys, if residual cleaning compounds are present and are exposed to high temperatures.
- Part surface condition - Rough surfaces tend to hold soil, making it harder to remove.
- Part surface accessibility and geometry - Complex shapes make it difficult to clean all of the surfaces, and soils lodged in restricted areas may escape the effects of cleaning.
- Required degree of cleanliness - The degree of cleanliness may be dictated by the postpenetrant inspection surface treatment or the service conditions the component will encounter.
- Availability and adequacy of cleaning facilities - For example, a large part cannot be placed in a small alkaline or ultrasonic cleaning tank.

2.2.9.2 Types of Contaminations and Soils.

2.2.9.2.1 Light Oils and Soft Films. Examples of light oils and soil films are: hydraulic oils, lubricating oils, machining and cutting fluids, thin greases, e.g., petroleum jelly, and film corrosion preventive compounds.

2.2.9.2.1.1 Effect: Light oils and soft films have several adverse effects on the penetrant inspection process. They readily enter surface openings, thus reducing or preventing penetrant entrapment. Oily materials on the part surface interfere with mechanisms which enable penetrants to enter and exit from discontinuities. Also, many oils and greases fluoresce under UV-A illumination. When on a part surface, this fluorescence could obscure a discontinuity indication or produce a false indication.

2.2.9.2.1.2 Removal: Oils and soft films may be removed by solvent washing, aqueous degreasing, or by ultrasonic cleaning with detergent or solvent. Vapor degreasing was the most effective method but has been discontinued due to environmental damage caused by the release of 1-1-1-Trichloroethane into the atmosphere. When present as thin films, these contaminants are easily removed by solvents. However, when they contain solid particles, e.g., metal chips, sand, or dirt, removal is more difficult. The oily phase is readily removed, leaving the solid particles adhering to the surface. Removal of the solid particles may require a mild mechanical action, e.g., hand wiping, pressure spray, solution agitation, or ultrasonic vibration.

2.2.9.2.2 Heavy Oils and Solid Films. Examples of heavy oils and solid films are viscous oils, thick greases, hard film corrosion preventative compounds, and particulate lubricants such as graphite and molybdenum disulfide. These contaminants or soils are more difficult to remove than light oils.

2.2.9.2.2.1 Effect: Heavy oils and solid films have the same adverse effects on penetrant inspection as light oils and soft films. Heavy oils and films on the surface of a part, even in trace amounts, interfere with the entry and exit of penetrant discontinuities. The heavy oils and greases are viscous and flow very slowly; many of them have excellent penetrating ability and readily enter surface discontinuities. Many heavy oils and semi-solid films fluoresce under UV-A illumination. This fluorescence can obscure valid indications and produce false indications.

2.2.9.2.2.2 Removal: Complete removal may require solvent or chemical action plus considerable mechanical action. Mechanical action can be solution agitation, manual scrubbing or pressure spraying. Cleaning for penetrant inspection presents special problems. Removal of heavy oils requires considerable mechanical action where the forces are concentrated at the surface. Use of excessive mechanical forces to remove heavy oils and films may further aggravate problems by smearing metal over narrow discontinuities.

2.2.9.2.3 Carbon, Varnish, and Other Tightly Held Soils. Examples of origins of carbon, varnish, and other tightly held soils are; partially burned petroleum and other combustion products, residues from evaporated fuel and oils, and dry film lubricants. The soils may have been baked at elevated temperatures to form a vitreous or glass-like coating.

2.2.9.2.3.1 Effect: Tightly held soils, e.g., carbon, engine varnish, and other dry soils, can seriously interfere with the penetrant inspection process. The soils can bridge over or partially fill the discontinuity, blocking or reducing the amount of penetrant in the void. When on the part surface, soils interfere with the forces or mechanism causing penetrant entry and exit from discontinuities. When dry, they tend to absorb moisture that also interferes with penetrant entry and exit. As surface contaminants, soils retain the penetrant, leading to a residual background and false indications during inspection.

2.2.9.2.3.2 Removal: Carbon, varnish, and tightly held soils are generally adherent and are difficult to remove. The soils require special cleaning compounds and processes to dissolve and loosen the soil. There are special solvent and alkaline cleaners for baked soil removal. Many of the paint removal materials and processes are used in removing carbon, varnish, and other tightly held soils that are not baked. Strong mechanical action, such as scrubbing, pressure spray, or solution agitation may also be required. Care must be used, since many of the cleaning compounds will attack metals and alloys.

2.2.9.2.4 Scales, Oxides, and Corrosion Products. Scale and oxides generally occur as a result of exposure to high temperatures.

2.2.9.2.4.1 Effect: Scale, oxides, and corrosion products can bridge or partially fill discontinuities restricting penetrant entry. When on the part surface, they interfere with the mechanism of penetration, impeding both penetrant entry and exit from discontinuities. They also retain penetrant on the surface, leading to a high residual background and false indications. Stress corrosion products occur within the flaws and may be impossible to completely remove. Penetrant inspection for stress corrosion cracking flaws generally requires extended dwell times to permit penetrant entry.

2.2.9.2.4.2 Removal: Scale and oxides are usually very difficult to remove and may require aggressive cleaning methods, such as acid pickling, abrasive blasting, or other metal removal operations. Some of these processes will have an adverse effect on the penetrant inspection process and should be avoided. Corrosion products, particularly from stress corrosion, often occur or are lodged within discontinuities resulting in removal problems.

2.2.9.2.5 Water or Moisture. Water or moisture on a part can occur from many sources. The most common source is inadequate drying after aqueous (water solution) cleaning.

2.2.9.2.5.1 Effect: Water or moisture on the part surface or in the discontinuity seriously interferes with the penetration process. It is essential that water be removed not only from the part surface but also from the inside of any discontinuities that may be present. Moisture in the form of condensation from high humidity or low temperatures may occur and must be removed.

2.2.9.2.5.2 Removal Method: Thorough drying of the component in an oven is the most effective method of removing water from part surfaces and within discontinuities.

2.2.9.2.6 Residues From a Cleaning Process. Effect: The chemicals used for cleaning solutions may contain strong alkalis and acids. If not completely removed from the part surface before penetrant inspection, they can interfere with the penetrant process in several ways. Residues can impede surface wetting and prevent the penetrant from evenly coating the inspection area. They also interfere with the mechanism causing the penetrant to enter and exit discontinuities. Strong alkalis and acids can decompose or degrade dyes and other chemicals in the penetrant, causing weak or faint indications. Chromate residues absorb UV-A, leaving less energy to excite the fluorescent dyes in the penetrant. Therefore, removal or neutralization of residual solution is always important and often imperative.

2.2.9.2.6.1 Removal: Complete removal of all cleaning process residues is very important. The usual process to accomplish removal is through the use of warm water and agitation followed by repeated immersions in fresh water. In some cases, residues of strong alkalis and acids are subjected to a rinse with a weak-neutralizing solution followed by fresh water rinses.

2.2.9.2.7 Residues From Previous Inspections. Residues from previous penetrant inspections can affect subsequent inspection results and the serviceability of the part. The effects of residues from previous penetrant inspections are discussed in the following paragraphs.

2.2.9.2.7.1 Inadequate Post-Inspection Cleaning Effects on Subsequent Inspections. If the post-inspection cleaning is inadequate, the residues must be considered as contaminants during a subsequent penetrant inspection. Developer residues on the part surface will retain penetrant causing a high residual background that can obscure valid indications. When retained in crevices, joints or faying surfaces, developer residues will cause false indications. Developer residues also absorb and retain moisture and, if not dried, may cause corrosion of the part. Penetrant residues, if not removed from discontinuities, will dry forming a varnish-like material in the flaw. This entrapped residue may not fluoresce and will reduce or prohibit entry of penetrant during future tests of the part.

2.2.9.2.7.2 Visible-Dye Penetrant Contamination.



DOD prohibits the use of Type II, visible-dye penetrant on aircraft, engine, and missile parts. Visible-dye penetrants SHALL NOT be used without specific engineering approval.

The red dye in visible-dye penetrant acts as a filter to UV-A radiation. When red dye residues mix with fluorescent penetrant in a discontinuity, the fluorescent brightness can be reduced or destroyed. Visible-dye penetrant SHALL NOT be used if the part may be inspected with fluorescent penetrant at some future time. If a part has been previously inspected with visible penetrant and requires re-inspection, the re-inspection should be performed using visible-dye penetrant. If fluorescent penetrant inspection is required to achieve the required sensitivity, special cleaning processes SHALL be used to ensure removal of all visible penetrant residues from previous inspections.

2.2.9.3 Cleaning Methods for Contamination/Soil Removal.

2.2.9.3.1 Alkaline Cleaning.

CAUTION

- With water based cleaning processes, drying time and/or temperature SHALL be sufficient for entrapped water to evaporate from within discontinuities before applying penetrant. A visibly dry surface may not be sufficient. Local procedures should specify minimum drying parameters.
- Some alkaline cleaning compounds will attack aluminum parts and components. Care SHALL be used in selecting the proper cleaning process for the materials to be cleaned. Traces of cleaner alkali remaining on test components after rinsing are objectionable because they might cause dermatitis or other health hazards or interfere with the action of liquid penetrants during the penetrant inspection operation.
- Aqueous cleaners containing silicates SHALL NOT be used before penetrant inspection. Cleaners with high silicate content can leave silicate residues in discontinuities blocking the penetrant from entering.

Alkaline cleaners are water solutions of chemicals, which remove soils by a chemical action such as saponifying (converting chemicals into soap) or displacement rather than dissolving the soils. Cleaners of this type usually have components to aid in lifting the soils from the part surface. After displacement, the soil may be carried as a suspension in the cleaner, it may separate, or in the case of fatty soils, react with the cleaner to form water-soluble soaps. Alkaline cleaning is usually accomplished in immersion tanks with the solution at or near its boiling point. The cleaning action is expedited by agitation. The four variables that affect the performance of an alkaline cleaning process are immersion time, agitation aggressiveness, solution concentration, and solution temperature. The cleaning process is more effective when each of these factors are increased. Following alkaline cleaning, parts and components must be thoroughly rinsed to remove any traces of the cleaning compound prior to penetrant inspection.

2.2.9.3.2 Steam Cleaning.

CAUTION

- Due to the risk of changes to material properties due to elevated temperature exposure, the Aircraft Corrosion Control Manual (NAVAIR 01-1A-509-1/TM 1-1500-344-23-1/TO 1-1-689-1) and (TO 1-1-691) restricts the use of steam cleaning.
- Steam cleaning SHALL NOT be used on aircraft and missile components unless specifically authorized. Elevated temperature exposure can result in changes to material properties, in addition steam cleaning can cause damage to composite structures, sealant, acrylic windows, and electrical wiring. Steam cleaning erodes paint, crazes plastic, debonds adhesives, damages electrical insulation, and drives lubricants out of bearings.
- Steam cleaning is a form of alkaline or detergent cleaning. Diluted solutions of alkaline cleaners, detergent cleaners, or mixtures of both are injected into a live steam spray. The steam/cleaner mixture is under pressure and the jet is directed at the part surface by a spray wand. Steam cleaning provides both chemical and strong mechanical action at elevated temperatures. Mobile steam generators permit application on parts and structures that cannot be brought into the cleaning shop.

2.2.9.3.3 Detergent Cleaning.

CAUTION

Detergent cleaners may be alkaline, acidic, or neutral but SHALL be non-corrosive to the material being inspected.

Detergent cleaners are water-based chemicals called surfactants, which surround and attach themselves to particles of surface soil. Solution agitation, pressure spray, or hand wiping then washes the particles of soil and detergent away. The action is identical to hydrophilic removers in the penetrant process. The cleaning properties of detergent solutions facilitate complete removal of light soils from the part surface, preparing it for penetrant inspection.

2.2.9.3.4 Emulsion Cleaning. Emulsion cleaners consist of an organic solvent and a detergent in a water-based solution. The organic solvent may be a petroleum-based liquid. The soils are removed through a combination of solvent and detergent action. The cleaner is lightly alkaline and is usually sprayed on the part. Emulsion cleaning may leave a light oil film (solvent residue) on the part surface; therefore, emulsion cleaned parts SHALL be hot water rinsed or wiped with a solvent to remove the oily residue prior to penetrant inspection.

2.2.9.3.5 Solvent Cleaning. Solvent cleaning removes soils by dissolving them. Solvents can be used on oils, greases, waxes, sealants, paints, and general organic matter. The resulting solution may leave a thin film or residue of an oily nature. This oily film must be removed with another solvent, vapor degreasing, alkaline, or detergent cleaning prior to penetrant inspection. Solvent cleaning may be accomplished by tank immersion, but more often applied by spraying or hand wiping when alkaline, detergent, or vapor degreasing is impractical.

2.2.9.3.6 Vapor Degreasing.

CAUTION

Titanium alloys must not be placed in a vapor degreaser or exposed to halogenated solvents. Halogenated solvents are those containing chlorine, fluorine, or other halogens.

In vapor degreasing the hot vapors of a volatile solvent are used to remove oils, greases, and waxes from metallic test objects in preparation for liquid penetrant testing. A steel tank fitted with a heater, solvent reservoir, condensing coil, and removable cover is used to heat the solvent to boiling, generating a vapor zone above the solvent. The vapor condenses on the relatively cool metal surface of parts placed in the vapor zone. The condensed solvent dissolves the organic contaminants on the part. Contaminated solvent condensation then drips back into the tank reservoir, carrying the contaminants into the bath. During evaporation only clean solvents are produced so the test parts are exposed to only clean soil-free solvent. Vapor degreasing is particularly suitable for removal of soluble organic contaminants, such as mineral oils, and greases. Vapor degreasing is not effective for removal of solid contaminants (carbon, varnish, paints, scale, corrosion products, or oxides). In some cases, restrictions are placed on vapor degreasing of chloride sensitive metals and alloys with halogenated degreasing solvents.

2.2.9.3.7 Ultrasonic Cleaning. This method utilizes ultrasonic agitation within a solvent detergent solution to accelerate the cleaning process. The agitation is the result of cavitations of the liquid when subjected to the high and low pressure (partial vacuum) of the ultrasonic waves. The formation and collapse of the cavities in the liquid provides a scrubbing action to the surface of the part. The agitation increases action of the cleaning solution and decreases cleaning time. Ultrasonic cleaning is particularly effective in removing contaminants trapped in discontinuities; however, its effectiveness is dependent upon the cleaning medium. It should be used with water and detergent on inorganic soils, e.g., rust, dirt, salts, and corrosion products. It should be used with an aromatic or halogenated solvent if the soil to be removed is organic, such as oil or grease. Ultrasonic cleaning has limitations, which affects its efficiency, part size, configuration, and the effectiveness of the cleaning solution for the type of soil to be removed.

2.2.9.3.8 Salt Bath Descaling and Deoxidizing. Molten salt baths are used for removing heavy, tightly held scale, and oxide from low alloy steels, nickel, and cobalt base alloys, and some types of stainless steel. Salt baths cannot be used on aluminum, magnesium, or titanium alloys. The process involves immersing the parts in molten caustic soda at about 700°F (370°C). The difference in thermal expansion between scale and base metal separates some scale and causes the remainder to

crack. The molten caustic soda also chemically reacts with the scale, reducing it to lesser oxides and metals. When the part is removed from the molten salt, it is plunged into water creating a thermal shock. Various amounts of scale can be blasted off as steam at the part surface, scours remaining scale from the part. Following quenching, the parts are rinsed in clean water.

2.2.9.3.9 Acid Cleaning.

CAUTION

Acid cleaning requires very careful control of procedures and solutions to prevent damage to the parts. Acid cleaning SHALL BE conducted ONLY by properly trained/qualified personnel.

Solutions of acids or their salts are often used to remove rust, scale, corrosion products, and dry shop soils. The type of acid and its concentration depends on the part material and contaminant to be removed. Acid cleaners are not generally effective on oily soils. Oils and greases must first be removed by some other cleaning method so the acid can react with the scale, oxides, or other tightly held soil.

2.2.10 Coatings.

NOTE

- Penetrant inspection SHALL NOT be performed on painted components or on parts contaminated with sealant unless these coatings and their residues are completely removed.
- Penetrant inspection SHALL NOT be performed on ion vapor deposition (IVD) coated components, or on chrome, cadmium plated, or high velocity oxi-fuel coated components unless specifically authorized by technical directive. Penetrant inspection SHALL NOT be performed on IVD coated components that have been abrasively blasted. IVD aluminum coatings are often not visually apparent. Therefore, the inspector SHALL obtain a determination before inspecting.
- Removal of conversion coatings such as alodine and anodize is not required prior to penetrant inspection provided the coatings do not result in excessive penetrant background that would interfere with the inspection. If the presence of conversion coatings results in excessive penetrant background they SHALL be removed prior to penetrant inspection. Obtain engineering direction prior to removing anodize.

Surface coatings (e.g., paint, anodize, ion vapor deposition (IVD) coatings, chrome plating, high velocity oxi-fuel (HVOF) coatings, etc.), are intentionally applied to the part surface to provide corrosion or wear protection. However, they can have several adverse effects on the penetrant inspection process. Many of the coatings such as paint, fuel sealant, and IVD coatings are elastic or are more ductile than the substrate and may not form openings when the base metal cracks from service stress. When this occurs, the surface opening is bridged or covered, preventing penetrant entry. On aluminum components with IVD aluminum coating, inspection with eddy current is recommended to supplement penetrant inspection in critical locations. IVD aluminum coatings are pure aluminum, are more ductile (deforms more easily) than the aluminum alloy substrate, and may conceal tight fatigue cracks from detection by penetrant. In addition, abrasive blasting (even relatively gentle PMB) of an IVD coated surface peens the soft aluminum surface to the extent that commonly used pre-penetrant chemical etching processes are insufficient to open cracks. Hard coatings such as chrome plating, HVOF coatings may often crack before the substrate due to contact wear or coating damage. Damage or cracking of these hard surface coatings can result in excessive non-relevant indications or may interfere with proper interpretation of relevant indications. Some hard anodize coatings and paint (especially when oxidized or weather checked) can retain penetrant during removal causing high residual background or false indications. Chrome, HVOF, IVD, anodize, and alodine coatings require specialized electro-chemical or mechanical removal methods and will not be discussed further in this document. Consult the responsible engineering authority for removal of these surface treatments. Typical methods for removal of paint, primer, and fuel sealant are discussed in the following paragraphs.

2.2.10.1 Coating Removal Methods. There are a large variety of paint coatings, primers, fuel sealant, and finish systems in use on aircraft parts and surfaces. Some conventional coatings are readily removed using standard methods, however, advances in technology have resulted in finishes that can only be removed with unique materials and techniques. There are three general types of coating removal methods: (1) chemical, (2) mechanical, and (3) burning or ignition. Critical structures can-

not tolerate the use of products that may be damaging to their metals or alloys. This requires careful attention when using abrasive techniques or chemical methods which may remove, etch, or embrittle the substrate.

2.2.10.1.1 Chemical Paint Stripping.

WARNING

When solvent removal techniques are used, it is essential to remove traces or residues of the solvents and other contamination using cleaning techniques discussed previously.

CAUTION

Paint strippers often contain toxic materials. Furthermore, only properly trained personnel SHALL accomplish surface preparation processes due to the various and potentially catastrophic effects various chemical paint strippers may have on different materials. This training SHALL be documented in personnel training records. NDI personnel are neither trained, nor experienced in performing paint stripping or cleaning.

NOTE

Many paint removal operations leave a thin film of dissolved or softened paint and remover chemicals on the part surface or in discontinuities. This often occurs when local or spot paint removal is performed. Care must be taken to ensure the area to be inspected is free of paint and remover residues since they interfere with the penetrant inspection process.

Chemical stripping is the preferred method for paint removal prior to penetrant inspection as it will not result in mechanical deformation of the substrate surface and if controlled properly, will result in a very clean surface. Various chemical paint strippers are available for both dip tank and in-place applications. There are two basic chemical paint stripping methods, solvent strippers and alkaline/acid strippers. The primary factors that influence the ease of paint removal include: (1) surface preparation before painting, (2) type of paint primer, (3) type of paint used, (4) number of paint coats, (5) age or cure of the paint finish, (6) type of paint removers used, and (7) nature of the substrate.

2.2.10.1.2 Mechanical Removal. Mechanical working removes soils and contaminates by physical action. This physical action may also remove or deform the part surface. Mechanical removal methods can be divided into two general categories: (1) abrasive blast, and (2) grinding/sanding/brushing.

2.2.10.1.2.1 Abrasive Blast. Abrasive blast media used to remove paint coatings include, but are not limited to, materials such as plastic media, glass bead, dry ice, and alumina grit. Plastic Media Blast (PMB) is often the preferred process for paint removal on aluminum and magnesium components due, largely, to its relatively minimal peening effect on the part surface. However, even though PMB has less effect on the surface than most other materials, it has been shown to cause enough surface deformation of aluminum and magnesium to cause crack closure and prevent fluorescent penetrant entry. In addition to closing cracks by the peening effect of the particles hitting the surface, abrasive blast may also clog cracks with residues of the abrasive media preventing effective penetrant inspection. Glass bead and alumina grit blast are considerably more aggressive processes and should only be used when specific engineering directive authorizes their use.

2.2.10.1.2.2 Grinding, Sanding, Brushing.

CAUTION

Power tools SHALL NOT be used for cleaning except when specific technical directives authorizes such use and should not be used if another cleaning method will work. Steel wire brushes SHALL NOT be used on nonferrous alloys.

Grinding, sanding, and brushing are typical mechanical methods used for localized removal of coatings such as paint and fuel sealant. These methods include the use of high-speed abrasive wheels, wire brushes, sand paper, emery cloth, and abrasive

polishing pads. Mechanical removal methods such as grinding, wire brushing, hand polishing and hand sanding can cause crack closure due to surface metal disturbance or obstruction of the crack opening due to entrapped grit. Crack closure can occur even when using fine abrasive media. Mechanical removal methods SHALL NOT be performed prior to penetrant inspection unless specifically authorized by engineering authority.

2.2.10.1.2.3 Etching After Abrasive Blast, Grinding, or Sanding. When accomplishing penetrant inspections, the preferred finish removal method is chemical. If the finish must be removed by mechanical means, an etch should be required prior to penetrant inspection. Failure to etch following mechanical removal of surface coating prior to penetrant inspection will degrade inspection sensitivity. If mechanical removal methods are used, etching should be performed prior to penetrant inspection unless specifically authorized by the appropriate engineering authority. Where a chemical cleaning process is specified and a mechanical process is used in its place, contact the appropriate engineering authority for guidance. Navy and Marine Corps personnel SHALL perform etching prior to penetrant inspection on aluminum and magnesium test parts when mechanical paint removal methods (including abrasive blasting), have been employed prior to penetrant inspection, unless otherwise directed by appropriate engineering authority. Swab application (ONLY) of etchants SHALL only be performed by NDI personnel who have properly documented training. Immersion application of etchants SHALL be accomplished by maintenance personnel who have properly documented training. Contact Navy engineering offices for guidance.

2.2.10.1.3 Burning/Ignition.

WARNING

Ignition or burning off of paint and primer SHALL NOT be used on aircraft components.

Many paint and elastomer coatings are easily removed or burned off by the application of high heat or flame. However, burning and ignition techniques are difficult to control and may result in damage to the substrate materials as a result of high temperature exposure. Removal of coatings by burning techniques is prohibited on aircraft components.

2.2.11 Effects of Surface Deformation, Wear, and Surface Roughness on Penetrant Inspection.

2.2.11.1 Surface Deformation and Wear.

CAUTION

- Surface deformation as a result of machining, grinding, wear, or shot-peening may reduce the surface opening of small discontinuities thus, reduce the effectiveness of the penetrant inspection process. Chemical etching may be necessary prior to penetrant inspection. Etching SHALL NOT be performed on shot-peened components unless specifically authorized by engineering authority.
- Severe mechanical working processes such as abusive machining, grinding, and shot peening can completely close the surface openings of large discontinuities and prevent the formation of penetrant indications. Penetrant inspection SHALL be accomplished prior to shot peening or other mechanical work processes that severely displace surface metal. If it is not feasible to perform penetrant inspection prior to these processes and pre-penetrant etch is not permitted, then another inspection method SHALL be considered. An exception to this requirement is when penetrant inspection is performed to detect discontinuities formed by mechanical working, such as machining tears or grinding cracks.

NOTE

If a conflict arises pertaining to the proper inspection method to use following mechanical working, the appropriate engineering activity SHALL be contacted for final determination.

Surface material deformation usually takes the form of metal flow or metal displacement. The amount of deformation depends on the type and severity of the working plus the ductility of the part. Deformation is typically a thin layer, surface metal flow that seals or reduces the opening of discontinuities. The smeared metal over the surface opening prevents or severely restricts the penetrant entry into any discontinuities. There are a number of mechanical processes that may deform the surface of a part. These processes include but are not limited to, machining, grinding, shot-peening, and surface wear. Forms of surface

wear include fretting and galling. Mechanical polishing and/or etching is often required prior to penetrant inspection to remove disturbed material and re-expose defect opening to the surface. Polishing and etching SHALL NOT be performed on shot-peened surfaces unless specifically authorized by the appropriate engineering authority.

2.2.11.2 Surface Roughness. Parts with excessive surface roughness present a unique challenge to penetrant inspection. Rough surface hinders the removal of excess surface penetrant resulting in high residual background and poor defect detectability. Surface polishing and subsequent etching may be required to reduce surface roughness prior to penetrant inspection.

2.2.11.3 Chemical Etching for Removal of Disturbed Surface Metal.

CAUTION

Chemical etching SHALL be performed by highly trained personnel and only with specific engineering approval and written detailed process and application instructions. Etching is not part of the NDI trade. NDI personnel are not qualified to perform chemical etching unless they have been separately trained and certified in the process(es).

Chemical removal or etching of deformed or disturbed surface metal is necessary if flaws are to be detected by penetrant inspection. Etching is performed using a mixture of appropriate acids or alkalis plus inhibitors. The type of etching solution depends on the part material and condition. Chemical etching requires very close control of the etching solution composition, process procedures, and time of contact. Minor deviations in processing parameters will result in a number of adverse effects, such as:

- Excessive metal removal.
- Selective etching (i.e. pitting) of critical surfaces.
- An increase in susceptibility to stress corrosion.
- Reduction of residual surface stress (shot peened surfaces) and a corresponding reduction in fatigue life.

SECTION III LIQUID PENETRANT INSPECTION EQUIPMENT

2.3 EQUIPMENT.

2.3.1 General. The equipment used in the penetrant inspection process varies from aerosol spray cans to complex automated systems. Some of the more generally used types of equipment are briefly described in the following paragraphs.

2.3.2 Portable Equipment. Portable penetrant inspection kits are for penetrant inspection of parts too large to be brought into the inspection lab, or for laboratories which process only a minimum number of parts requiring penetrant inspection. Penetrant materials are in small lightweight kits that can be easily transported to any location. Such kits are available for both visible and fluorescent penetrant processes and usually contain aerosol spray cans of penetrant, solvent remover, and developer. Penetrants may also be provided in small containers with a brush for penetrant application. Generally, portable penetrant applications are limited to localized area or spot inspections rather than entire part surfaces.

2.3.3 Stationary Inspection Equipment - General Purpose. The type of equipment most frequently used in fixed installations consists of a series of modular workstations. At each station an inspector performs a specific task. The number of stations in a processing line varies with the type of penetrant method used. A penetrant line will typically have the following stations:

- Penetrant application station (dip tank/spray booth).
- Emulsifier/remover application station. (Methods "B" and "D". Method "D" systems SHOULD include a rinse station prior to the remover tank. This station is not applicable to Method "A".)

- Rinse station with UV-A lamp.
- Developer application station (if aqueous or nonaqueous developer is used).
- Drying oven.
- Developer application station (if dry-powder is used).
- Inspection booth with UV-A lamp.

CAUTION

When installing stationary penetrant tanks, ensure drain pipes are made from stainless steel or copper IAW MIL-PRF-32531. PVC pipe SHALL NOT be used as the effluent from penetrant will dissolve the PVC over time and leak onto the floor.

2.3.3.1 Drain and dwell stations may be placed between each primary station depending on the method and equipment configuration use.

2.3.4 Small Parts Inspection Systems. There are inspection systems designed specifically for processing small parts. These units are smaller than the general systems described in [Paragraph 2.3.3](#) above, and some of the stations serve multiple purposes. In use, the parts are loaded into wire baskets, then batch processed through each of the stations. The wash station may contain a water-driven, rotary table with spray jets to supplement the hand-held spray wand.

2.3.5 Automated Inspection Systems. The penetrant inspection process can be adapted for use with fully and semi-automated processing equipment. Semi-automated systems consist of a conveyor belt or table for moving the parts through one or more of the processing steps. Applications of penetrant, emulsifier or remover, rinse, or developer are manually performed. In fully automated systems, all of the processing steps are mechanically performed without an operator. Automated equipment allows large numbers of parts to be rapidly processed with a minimum of personnel and time. Automated equipment also provides a more uniform, though not necessarily more sensitive, testing process.

2.3.6 Inspection Lamps.

2.3.6.1 Inspection Lamp Sources. Inspection Lamp Sources. Fluorescent materials used in nondestructive testing generally respond most actively to radiant energy with a wavelength of about 365 nm. This wavelength represents near ultraviolet or UV-A radiation, light just outside the visible range on the blue or violet side, but not sufficiently far removed to be in the ultraviolet range. Because it is invisible, radiation at this frequency is commonly referred to as UV-A. Common sources of near UV-A radiation include:

- Incandescent lamps.
- Metallic or carbon arcs.
- Integrally filtered tubular fluorescent lamps.
- Tubular fluorescent lamps.
- Enclosed mercury vapor arc lamps.
- High intensity discharge (HID), metal halide, micro-discharge, or xenon lamps.
- Light-emitting diodes (LED)

Because of the potential hazards associated with the high ultraviolet output as well as concerns with beam characteristics, and the potential for fluorescent penetrant fade from high intensity UV exposure, the following restrictions SHALL be enforced:

- Only mercury vapor, high intensity discharge or light emitting diodes lamps SHALL be used for part inspection.
- Lamps that emit greater than 10,000 $\mu\text{W}/\text{cm}^2$ at 15 inches SHALL NOT be used.
- Spot or variable focused reflectors or lens SHALL NOT be used.
- Projected beams SHALL NOT exhibit a dead spot.
- Ultraviolet filtering safety eyewear SHALL be worn. Eyewear designed to filter out wavelengths below 400 nm is recommended.
- Precautions SHALL be taken to cover exposed skin that is exposed to the direct beam of any UV-A lamp.
- UV-A intensity of battery powered UV-A lamps shall be tested before and after each job. More frequent checks are recommended when the intensity is approaching the required minimum.

2.3.6.1.1 Incandescent and Carbon Arc Systems. Electric current heating a tungsten element to incandescence is the most familiar visible light bulb familiar to everyone. The wavelength of the associated electromagnetic radiation is generally in the visible and infrared range. It is characterized by large amounts of heat (infrared) and visible light. Electric current arcing between two carbon electrodes generates a high quantity of electromagnetic radiation in the carbon arc lamp. The radiation spans a range of wavelengths from about 10 nanometers to over 10 micrometers. This covers the entire ultraviolet and visible light ranges and a portion of the infrared range; however, little if any useful ultraviolet radiation is produced. In addition, the lamps require a high electrical power supply and are very bulky or large due to the need for electrode drive mechanisms. Incandescent and carbon arc systems are not used for fluorescent penetrant inspection.

NOTE

Incandescent carbon arc lamps SHALL NOT be used for penetrant inspection.

2.3.6.1.2 Low Pressure Fluorescent "BL" Bulbs.

NOTE

Fluorescent bulbs SHALL NOT be used for detecting fluorescent indications.

Low pressure, fluorescent bulbs are similar to standard fluorescent tubes, however, instead of an inert gas, the tube contains metallic mercury. When an electric current is applied, the mercury vaporizes and emits hard (deeply penetrating) ultraviolet radiation with a wavelength of approximately 254 nm. This wavelength is not useful for fluorescent penetrant inspection. Therefore, the inside of the tube is coated with a phosphor activated by the hard ultraviolet and emits black and visible light in the wavelength range of 320 to 400 nm. The amount of useful UV-A at 365 nm is relatively small; however, there is a large amount of both harmful short wavelength ultraviolet radiation (below 320 nm), and visible light, (above 400 nm), emitted through the phosphor. Some of these undesirable wavelengths are removed by the use of filters. While this reduces the unwanted radiation, it also reduces the already low amount of useful UV-A in the range of 365 nm. In addition, fluorescent UV-A bulbs, because of their configuration, cannot be easily focused and their intensity per unit area is below other types of bulbs. Most fluorescent bulbs will not produce an output sufficient to meet the minimum UV-A intensity requirements ([Paragraph 2.5.4.1.3](#)), also required by ASTM E1417.

2.3.6.1.3 Mercury Vapor Arc Bulbs.

NOTE

Bulbs, less than 100-watts, SHALL NOT be used for penetrant inspection unless specifically authorized.

High pressure, mercury vapor arc bulbs are the most common sources for UV-A. They are also recommended for fluorescent penetrant inspection because they have an acceptable output at a reasonable distance from the bulb. They can be focused to in-

crease their intensity over a localized area. They are available in a wide range of sizes from a 2-watt pencil type used for special applications, to a 400-watt floodlight. The most frequently used size is the 100-watt bulb mounted in a variety of fixtures or housings and fairly portable. A cross-section of a typical mercury vapor, arc discharge bulb is shown in [Figure 2-9](#).

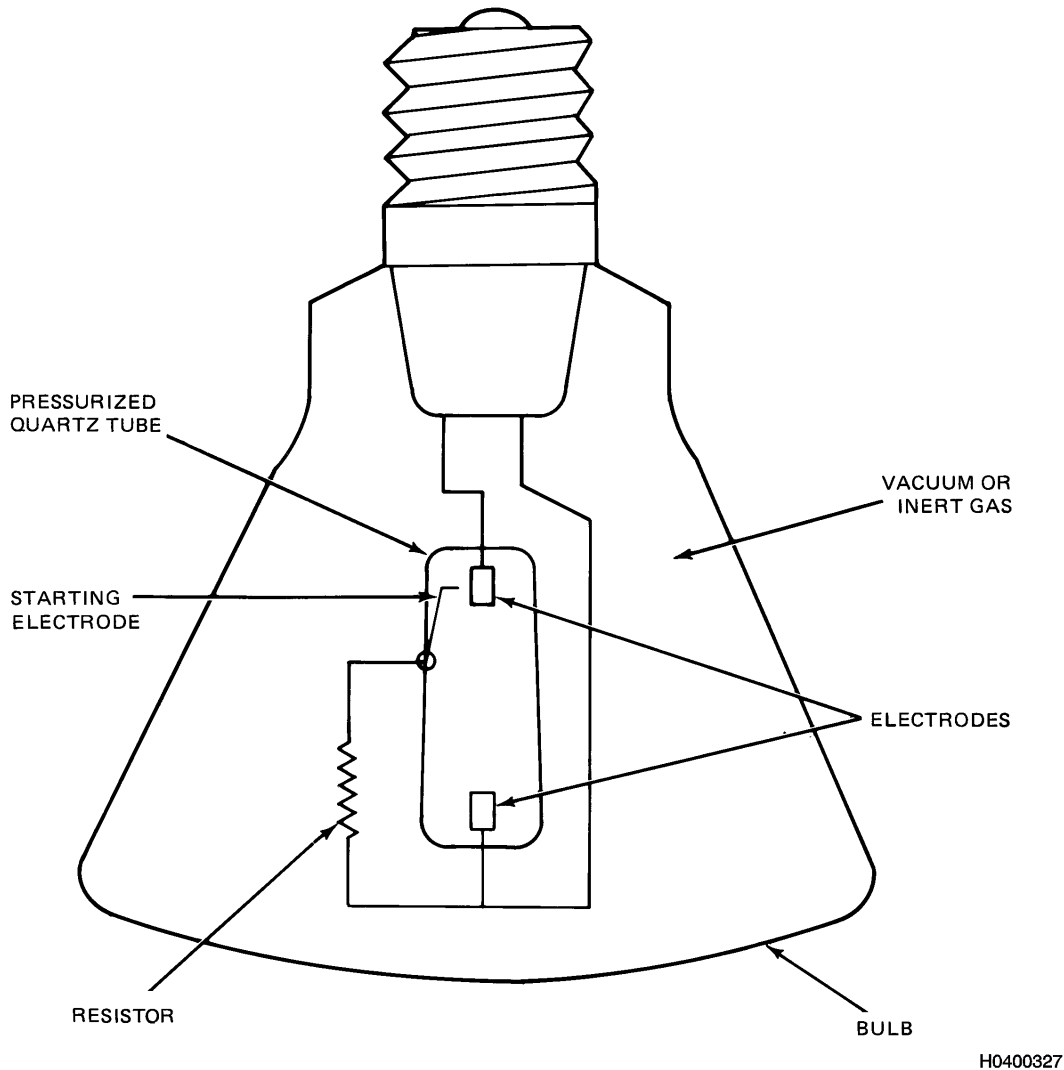


Figure 2-9. Cross-Section of a Typical High-Pressure Mercury Vapor Arc Bulb

2.3.6.1.3.1 Warm-Up Requirements for Mercury Vapor Bulbs.

NOTE

UV-A lamps (UV-As) SHALL NOT be used for inspection before the required intensity at the inspection surface ([Paragraph 2.5.4.1.3](#)) is achieved.

The high-pressure component is a quartz tube containing some mercury plus a small amount of neon gas. When the lamp is first turned on, the mercury is condensed as a liquid and an arc between the electrodes cannot be generated, this is the reason for the neon gas. A small amount of current, limited by the resistor, causes a discharge from the starting electrode through the neon gas. This glow is sufficient to vaporize the mercury, which then allows the arc to pass between the main electrodes. This starting procedure requires from 5 to 15 minutes to fully vaporize the mercury and produce full output of UV-A. Some UV-A lamps may be warmed-up in 2-3 minutes, refer to the owner's manual of the light you are using.

2.3.6.1.4 High Intensity Discharge (HID) UV-A Light Sources.

WARNING

- High intensity discharge (HID) lamps shall only be used when approved by the appropriate service NDI Program Office or by engineering directive due to problems associated with excessive white-light emission, veiling glare (see [Paragraph 2.5.4.1.6.1](#)) and poor beam characteristics.
- Due to the potential for exposure to high intensity ultraviolet light, use of UV filtering safety glasses, goggles, or faceshields is required. Since highly focused UV-A lamps provided by some spot light configurations might result in eye injury if exposed for more than a few seconds, only flood reflector equipped gas discharge lamps SHALL be used. Skin exposure SHALL also be avoided. Precautions SHALL be taken to cover exposed skin that is exposed to the direct beam of any UV-A source.
- High intensity discharge (HID) lamps produce radiation by making an electric arc in a mixture of gases. HIDs have compact arc tubes that contain a high-pressure mixture of argon, mercury, and a variety of metal halides. The mixture of halides will affect the nature of radiation produced, influencing the correlated color temperature and intensity (i.e. emitting high UV content for example). The argon gas in the lamp is easily ionized, and facilitates striking the arc across the two electrodes when voltage is first applied to the lamp. The heat generated by the arc then vaporizes the mercury and metal halides, which produce light as the temperature and pressure increases.
- HID UV-A sources have broad emission spectra which may include more than one peak within the UV-A range. For use in fluorescent NDT, these lamps must have appropriate filters, either internal or external to the light source, to pass UV-A and minimize visible light output detrimental to the fluorescent inspection process.

2.3.6.1.4.1 There are three types of high intensity UV-A sources; metal halide, micro-discharge and Xenon.

- Metal Halide UV-A sources : The high intensity flood fixture normally uses a high wattage metal halide bulb. This lamp will also contain some type of specially coated parabolic reflector. The high intensity of this lamp will produce a great deal of heat, so some type of cooling fan must be used.
- Micro-Discharge Lamp (MDL) UV-A sources: The MDL lamp uses a 35 watt metal halide bulb and therefore produces very little heat. Normally, a cooling fan is not required.
- Xenon Bulb UV-A sources : These lamps use a high pressure arc bulb containing xenon gas or a mixture of mercury vapor and xenon gas.

2.3.6.1.4.2 HID lamps have many advantages over Mercury Vapor Arc lamps. These include: they have very short warm-up times (10-15 seconds), are lightweight, generate very little heat, and produce as much as 45 times greater ultraviolet output than most common lamps available.

2.3.6.1.5 Light Emitting Diodes (LEDs).

2.3.6.1.5.1 Light emitting diodes (LEDs) are solid state electronic devices consisting of a semiconductor or semiconductor elements that emit radiation or light when powered by a current.

2.3.6.1.5.2 The wavelength of the light (corresponding to the energy of the photon) is determined by the chemistry of impurities, called dopants, of the semiconductor. The selection of the dopant material determines the wavelength and intensity of the emitted radiation. Therefore a primary advantage of the LED technology is that the characteristics of the emitted radiation can be tailored by modifying the dopant.

2.3.6.1.5.3 Many LED UV-A hand-held lamps and overhead lamps consist of an LED array to provide a broad beam to irradiate large inspection areas. Individual LED elements are generally as small as 1 mm² and include integrated optical components that may be used to shape its radiation pattern or filter the spectral content ([Figure 2-10](#)). LED lamps provide many advantages over traditional mercury vapor light sources including lower energy consumption, longer lamp lifetime, im-

proved robustness, smaller size, faster light-on times, and greater durability and reliability. LEDs powerful enough for high intensity UV-A lamps are relatively expensive but because of their low power requirements can be battery operated providing great portability.

2.3.6.1.5.4 Many LED UV-A lamps are currently available on the open market. Unfortunately many of these lamps are not designed for fluorescent penetrant or magnetic particle inspection and therefore do not have the optimum spectra content or beam quality required for NDI applications. Many LED lamps have been found to emit excessive white light or very high UV-A intensity that can result in excessive veiling glare. Others do not emit UV-A within the required 360-370 nm range and therefore may not adequately excite the fluorescent dye within the penetrant or magnetic particles. Some lamps have also been found to exhibit dead-spots (insufficient UV-A intensity) in the center of the projected beam as a result of poorly designed reflectors, filters, or LED array design. Poorly designed LED arrays can result in irregular project beam profiles and “dead-zones” within the beam pattern that do not provide sufficient UV-A intensity. An industry standard, ASTM E3022, was developed to address these issues and establish minimum performance requirements for UV-A lamps used for fluorescent penetrant and magnetic particle inspection methods.

2.3.6.1.5.5 LED UV-A Lamp Classifications.

CAUTION

- Type C, UV-A LED “torch” lamps SHALL NOT be used for inspection of large areas or inspection within a stationary booth unless specifically required by a part specific procedure or approved by the responsible engineering authority. Type C lamps may be used for portable inspection of focused inspection areas.
- The irradiance (UV-A intensity) of Type B and C, UV-A (battery powered) lamps SHALL be checked before and after each inspection. The post inspection check SHALL be performed before turning off the lamp. If the lamp is accidentally turned off, then turn on the lamp for 5 minutes before conducting the post inspection check.

2.3.6.1.5.6 UV-A LED lamps used for nondestructive testing are classified in accordance with ASTM E3022 as follows:

- Type A - Line-powered lamps - LED arrays for handheld and overhead applications.
- Type B - Battery powered hand-held lamps - LED arrays for stationary and portable applications.
- Type C - Battery powered hand-held torch lamps - single LED flashlight or torch for portable or special applications.

2.3.6.2 Battery Powered Lamps. Great care must also be exercised when using battery powered lamps. Depending on the lamp design, as the battery drains, a significant reduction in UV-A intensity may occur. As a result, the UV-A intensity may be adequate at the beginning of the inspection but may not be adequate at the end of the inspection, depending on the battery life and duration of the inspection. The UV-A intensity SHALL be checked before and after inspections using battery powered lamps. If the lamp is accidentally turned off before the post-inspection check, the lamp SHALL be turned on for 5- minutes before performing the post-inspection irradiance measurement. [Figure 2-10](#) illustrates the drop in UV-A intensity (irradiance) for two different LED UV-A lamps as the battery depletes. Lamp A contains a circuit that provides a nearly constant irradiance (intensity) throughout the entire battery discharge time. This is the preferred design. Because of the potential for UV-A intensity reduction and additional process control requirements, battery powered UV-A lamps should only be used for portable inspection.

2.3.6.3 Inspection Lamp Fixtures.

CAUTION

UV-A bulbs SHALL NOT be operated without filters. Cracked, chipped, or ill-fitting filters SHALL be replaced before using the lamp. High intensity "super" UV-A lamps that use bulbs with integral filters SHALL have a splash-guard attached to the front of the lamp housing to prevent accidental implosion of the bulb.

High pressure, mercury vapor bulbs require a housing, filter, regulating ballast or transformer, and connecting cables or wires. The housing, which may be metal or plastic, serves several functions:

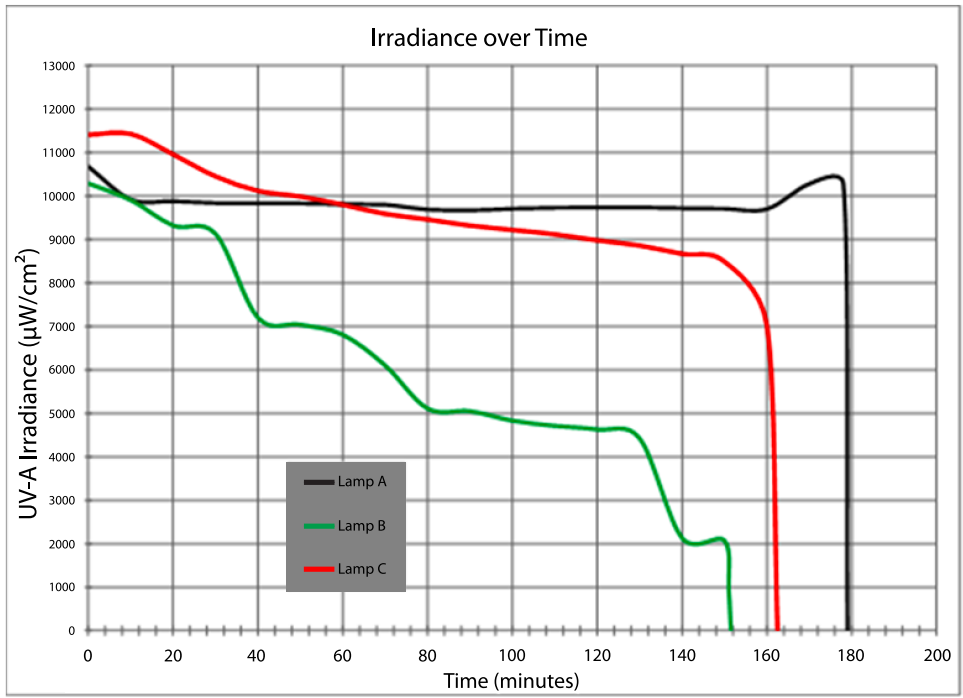
- Hold and protect the bulb.
- Hold and support the filter.
- Prevent leakage of unwanted visible light.
- Permit directing the beam on the surface to be inspected.
- Provide a means for handling the bulb.

2.3.6.4 Inspection Lamp (UV-A Pass) Filters.

NOTE

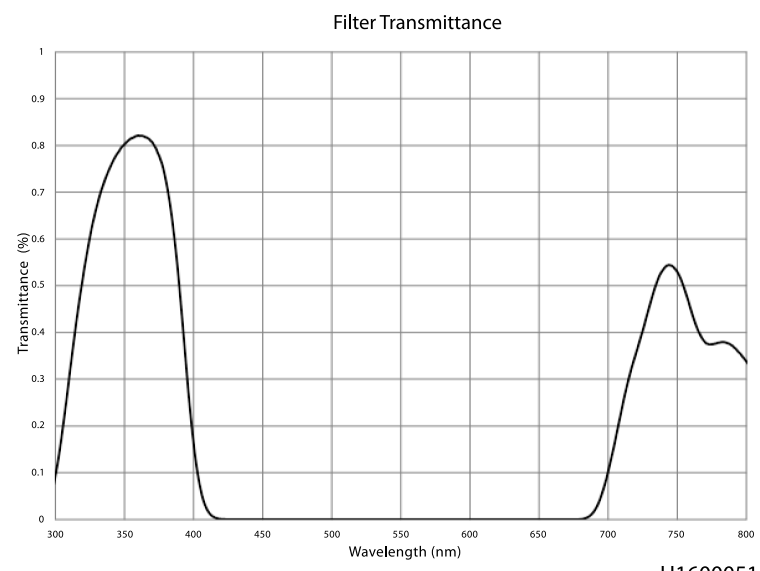
All UV-A lamps, including LED lamps shall be fitted with a UV-A pass filter.

The filter is a special material that prevents the passage of short wavelength ultraviolet (< 320nm) and long wavelength visible light (400nm - 700nm) and allows UV-A (320nm - 400nm) to pass. This wavelength causes maximum fluorescence of the penetrant dyes. The transmission characteristics of typical UV-A pass filter is shown ([Figure 2-11](#)). Filters for penetrant inspection can be either a smooth or fluted surface. The fluted surface provides a slightly larger focused spot than a smooth surface filter.



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Figure 2-10. Change in UV-A Irradiance Over Time as Batteries Deplete



H1600051

Figure 2-11. Transmission Curve for a Typical UV-A Pass Filter

2.3.7 Process Control Equipment. The performance of liquid penetrant inspection systems depends on the processing material quality of pre-cleaning chemicals, liquid penetrant, emulsifier, developer, and the continued proper functioning of the several processing stages. A sudden undetected deterioration of one of these processing stages may result in missing an indication. To learn more about the equipment used to monitor the penetrant process ([Paragraph 2.6.7](#)).

2.3.7.1 UV-A Lamp Performance. Lamp performance is assessed through measurements of beam intensity and projected beam profile. Beam intensity and projected beam profile limitations are stated in TO 33B-1-2 WP 103 00.

NOTE

All UV-A lamps SHALL contain a UV-A pass filter.

2.3.7.1.1 UV-A Beam Intensity. UV-A lamps are required to produce a minimum amount of UV-A radiation as measured with a radiometer at a distance of 15 inches from the filter. The peak intensity measurement should be recorded to monitor lamp/bulb degradation.

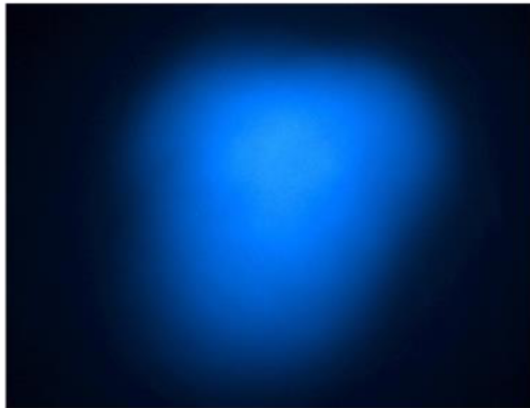
2.3.7.1.2 UV-A LED Projected Beam Profile. A UV-A lamp's projected beam profile is the area (circle) of the beam that maintains a minimum amount of UV-A intensity measured at 15 inches from the filter. Mercury vapor and gas discharge lamps are older technologies that are being phased out. LED UV-A lamps are newer technologies that are intended to have higher intensity and a larger projected beam profile than mercury vapor or gas discharge lamps. Projected beam profiles are typically assessed as a 3 inch or a 5 inch diameter area that meets a specific UV-A intensity.

2.3.7.1.3 LED Lamp Manufacturer Certifications. Due to unique characteristics of UV-A LED lamps, a new industry standard was established (ASTM E3022) to address their unique performance requirements. Lamp manufacturers SHALL provide a certification that the supplied UV-A LED lamp/bulb meets all requirements of ASTM E3022 to include but not limited to the following:

- UV-A LED lamps SHALL provide a minimum peak UV-A intensity of at least 2000 micro-watts per square centimeter ($\mu\text{W}/\text{cm}^2$) when measured at a distance of 15 inches.
- Type A (line powered arrays) and Type B (battery powered arrays) Lamp LED Arrays SHALL provide a minimum UV-A intensity of 1000 $\mu\text{W}/\text{cm}^2$ over a 5 inch diameter circle when measured at a distance of 15 inches.
- Type C, (battery powered single element) LED torches, SHALL provide a minimum UV-A intensity of 1000 micro-watts per square centimeter ($\mu\text{W}/\text{cm}^2$) over a 3 inch diameter circle when measured at a distance of 15 inches.
- The peak wavelength SHALL be between 360 nm and 370 nm.
- The lamp SHALL NOT exhibit any flicker or strobing during operation.
- All UV-A LED elements shall be fitted with UV-A pass filter.

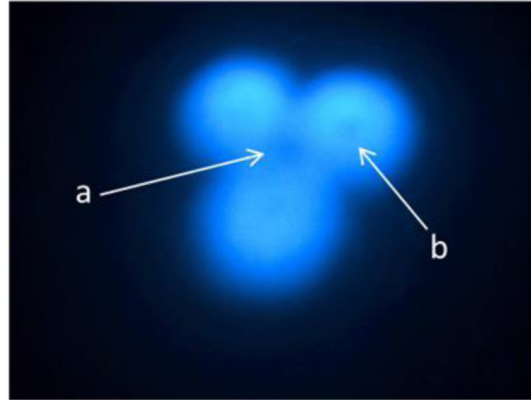
In addition to the manufacturer's certifications, the following requirements SHALL also apply:

- Lamps that emit greater than 10,000 $\mu\text{W}/\text{cm}^2$ at 15 inches SHALL NOT be used.
- LED arrays SHALL NOT exhibit beam non-uniformity "dead zones" when held greater than 6 inches from the inspection surface (see [Figure 2-12](#)).
- (USAF only) Visible light LEDs SHALL NOT be incorporated in the lamp.



Uniform Beam

3-LED Array - Away from Inspection Surface
(Beam Profile may be rectangular, oval,
circular or triangular)



Non-Uniform Beam

3-LED Array - Near Inspection Surface
Arrow indicate regions of reduced irradiation, (a)
between individual LED beams and (b) due to
individual LED beam profiles

H1600052

Figure 2-12. EXAMPLES OF UNIFORM VERSUS NON-UNIFORM BEAM PROFILES FROM AN LED UV-A ARRAY

SECTION IV LIQUID PENETRANT APPLICATION METHODS

2.4 APPLICATION METHOD.

2.4.1 **General.** This section provides basic, intermediate, and detailed information on the specific processes relative to the performance of penetrant inspection. Functions not specifically performed by NDI personnel, such as general cleaning, are not covered under this section.

2.4.2 **Basic Penetrant Processes.** Abridged penetrant process flow charts illustrating the general process steps for the four penetrant methods are provided in [Figure 2-13](#) through [Figure 2-16](#). Detailed descriptions of application procedures are contained in later sections and paragraphs. The process flow charts contain reference locations for the detailed information. Since the application procedures for fluorescent (Type I) and visible-dye (Type II) penetrants are similar, the process flow charts are applicable to both types of penetrants.

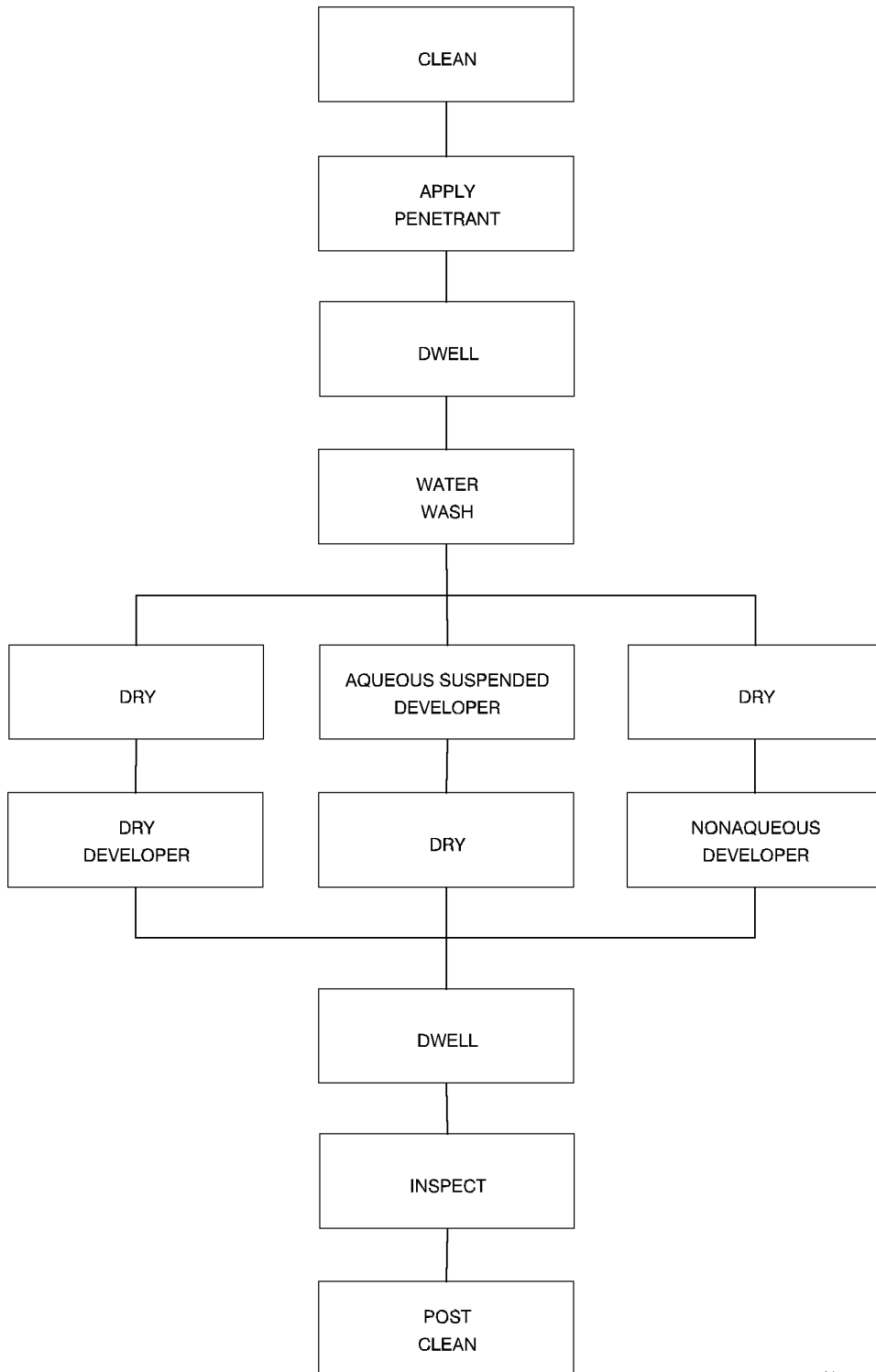
NOTE

Weapon system and commodity specific inspection techniques SHALL be developed and approved IAW [Paragraph 1.3.5.1](#) and TO 00-5-1. If needed, contact the responsible Air Logistic complex (ALC) NDI Manager or responsible engineering authority for assistance.

2.4.2.1 **Basic Inspection Steps.** The basic fundamentals of the penetrant process have not changed from the oil-and-whiting days. [Figure 2-1](#) provides an illustration of the basic principles of the penetrant inspection process, while more explicit process details are discussed in subsequent sections of this chapter. The following provides a simplified description of the fundamental penetrant process steps.

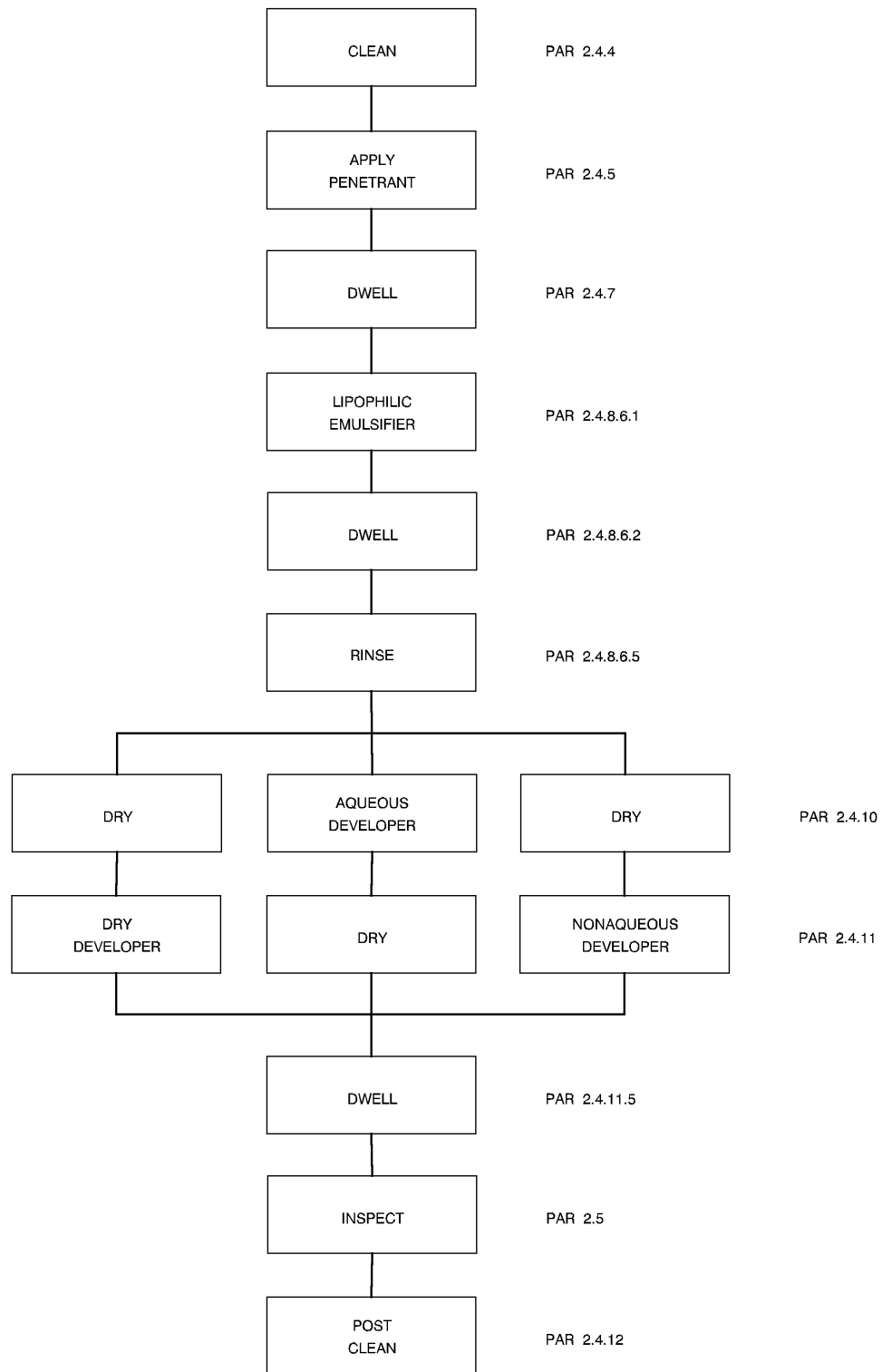
- a. Cleaning is performed to remove residues and soils from the part surface. Cleaning is a critical part of the penetrant process and is emphasized because of its effect on the inspection results. Contaminants, soils, or moisture, either inside the flaw or on the part surface at the flaw opening, can reduce the effectiveness of the inspection. For a complete discussion on the precleaning process ([Paragraph 2.4.4](#)).

- b. After cleaning is complete and the part is thoroughly dry, a penetrating liquid containing dye is applied to the surface of a clean part to be inspected. The penetrant is allowed to remain on the part surface for a period of time to allow it to enter and fill any surface breaking openings or discontinuities. For a complete discussion of the penetrant application and dwell process ([Paragraph 2.4.5](#) and [Paragraph 2.4.7](#)).
- c. After a suitable dwell period, the penetrant is removed from the part surface. Care SHALL be exercised to prevent removal of penetrant contained in discontinuities. For a complete discussion on the penetrant removal process ([Paragraph 2.4.8](#)).
- d. A material called a developer is then applied. The developer aids in drawing any trapped penetrant from discontinuities and improves the visibility of indications. For a complete discussion on the development process ([Paragraph 2.4.11](#)).
- e. Following developer application the next step is a visual examination under appropriate lighting conditions to identify relevant indications. For a complete discussion on the examination/interpretation process ([Paragraph 2.5](#)).
- f. The final step is a post-cleaning of the part. This step is very important as penetrant residues can have several adverse effects on subsequent processing and service. For a complete discussion on the post-cleaning process ([Paragraph 2.4.12](#)).



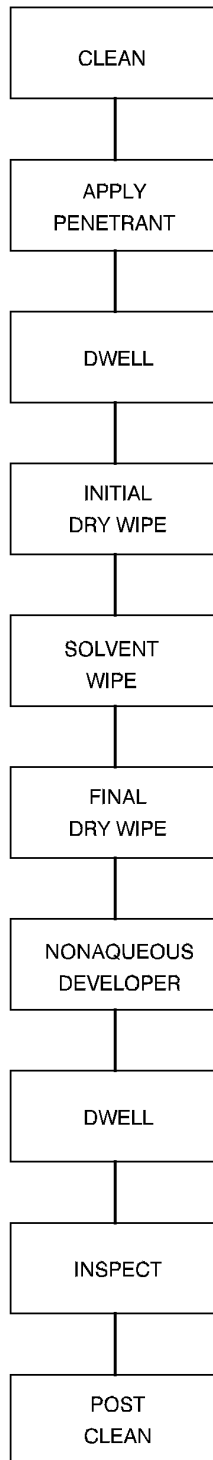
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Figure 2-13. Flow Chart for Water Washable Penetrant Process (Method A)



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Figure 2-14. Flow Chart For Post-Emulsifiable Lipophilic Penetrant Process (Method B)



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Figure 2-15. Flow Chart for Solvent Removable Penetrant Process (Method C)

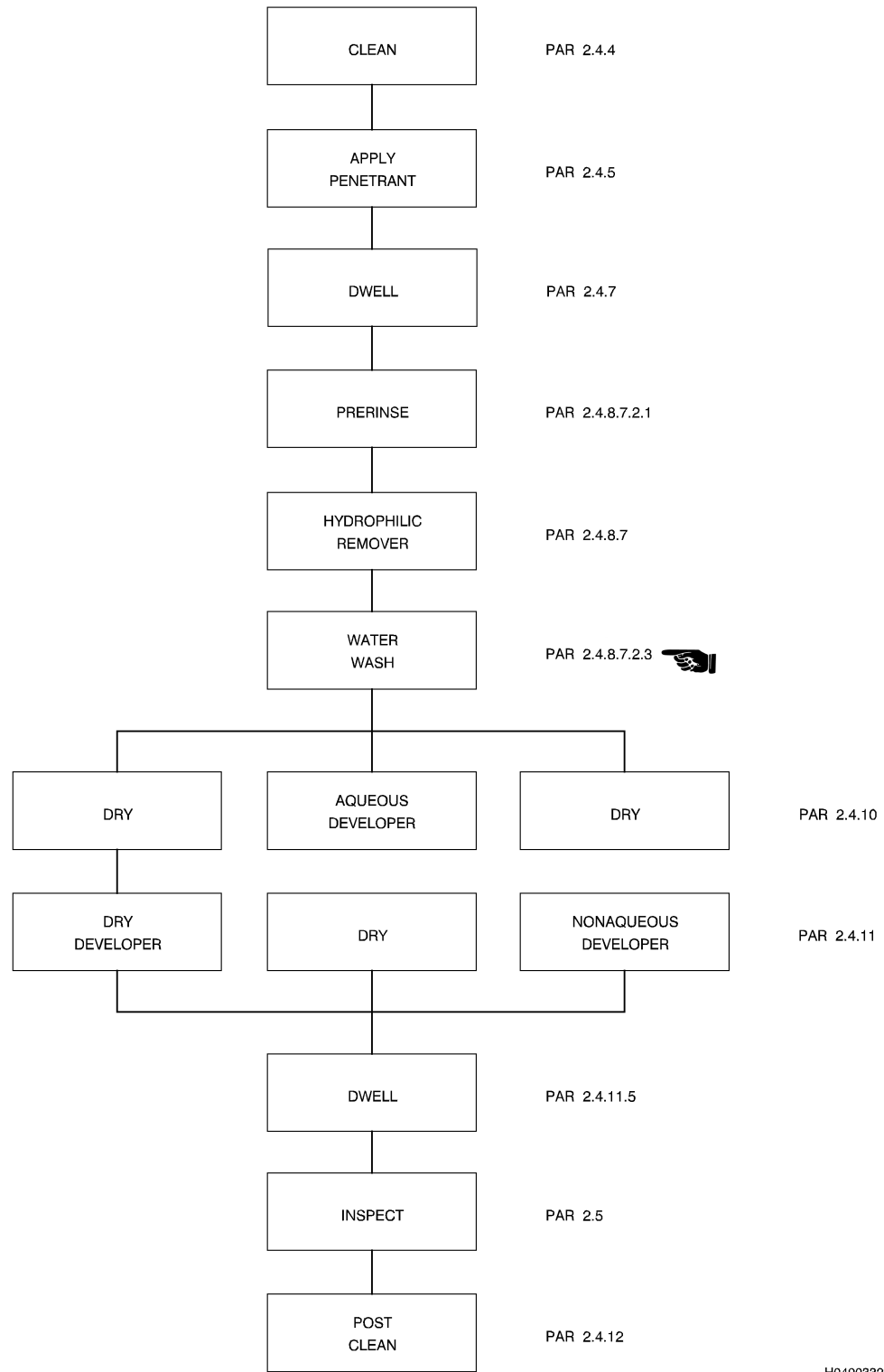


Figure 2-16. Flow Chart for Post-Emulsifiable Hydrophilic Penetrant Process (Method D)

2.4.3 Pre-Testing.

NOTE

All nonmetallic parts not previously inspected, and which do not have approved technical or nondestructive inspection procedures SHALL be pre-tested.

Some nonmetallic parts, such as plastics, rubbers, and Plexiglas may react with the oils and solvents contained in penetrant inspection materials. These oils and solvents can cause swelling, softening, distortion, crazing, or other surface effects resulting in damage to the part. The purpose of pre-testing is to ensure parts to be inspected will not be damaged by penetrant materials.

2.4.3.1 Pre-Testing Procedure.

NOTE

Specific inspection guidance SHALL be provided by the agency requiring the inspection. If necessary, the responsible Air Logistic Complex (ALC) NDI Manager or responsible engineering authority SHALL be contacted for assistance. Some materials may not show effects until they are subjected to service conditions (aging, cold, heat, moisture).

Pre-testing SHALL be performed as follows:

- a. If spare or extra parts are available, the entire surface to be inspected may be pre-tested. If the part to be inspected must be reused, the pretest SHALL be performed on a small area where possible damage can be tolerated.
- b. The part to be pre-tested SHALL be cleaned and visually examined for evidence of pre-existing damage.
- c. Apply the penetrant to be used to the area selected and allow it to remain on the surface for at least twice the proposed dwell time. Wipe excess penetrant from the area and closely examine for any surface changes.
- d. Repeat step c with the remover and developer to be used, examining the part surface for any evidence of change between each process step.
- e. If any evidence of adverse effects is noted, the penetrant inspection method SHALL NOT be used.

2.4.4 Pre-Cleaning Performed by NDI Personnel. Pre-cleaning is the surface preparation performed by NDI personnel prior to an inspection. The purpose of pre-cleaning is to remove light soils and contaminants that have accumulated since major cleaning, touch-up critical areas such as bolt threads, and remove residue from other cleaning processes. Parts requiring more extensive cleaning will be sent to the appropriate cleaning shop or corrosion control facility.

2.4.4.1 Pre-Cleaning With Aerosol Spray Solvents.

WARNING

Isopropyl Alcohol and most Class 2 solvent removers are flammable.

CAUTION

With the elimination of the use of 1.1.1 trichloroethane (methyl chloroform), the solvent remover in portable penetrant kits is most likely to be Class 2 (non-halogenated). Only solvent removers listed in QPL-SAE-AMS-2644 SHALL be used for pre-cleaning just prior to penetrant inspection. Technical grade Isopropyl Alcohol (TT-I-735, Grade A) is also acceptable. Significant care must be taken to ensure solvent has completely evaporated before penetrant application.

Most Class 2 solvent removers are hydrocarbon solvents such as aliphatic naphtha. While they are excellent solvents, because of their high boiling point (in excess of 300°F or 149°C) such Class 2 solvent removers will not rapidly evaporate at room temperature. Consequently, when used as a pre-cleaner, care SHALL be taken to assure there is no residual solvent remover on the part surface prior to the application of penetrant. This can be accomplished by thoroughly drying the surface with a lint free cloth or rag, dry the part in an oven, or alternatively, use a more volatile solvent such as Isopropyl Alcohol to remove the less volatile solvent remover. Portable penetrant kits contain aerosol spray cans of penetrant, developer, and solvent remover. The solvent remover is used in three ways 1) it serves as a pre-cleaner before penetrant application, 2) it removes the last of the excess penetrant after completion of the penetrant dwell, and 3) it serves as a post-cleaner to remove residual penetrant materials when the inspection has been completed.

2.4.4.2 Method of Applying Spray Solvent as a Pre-Cleaner.

CAUTION

When used as a pre-cleaner, the solvent remover may be sprayed directly on the test surface. Solvent SHALL NOT be sprayed directly on the surface of parts when removing excess surface penetrant during a penetrant inspection process.

The method of applying spray solvent remover as a pre-cleaner is different than when it is used to remove penetrant following penetrant dwell. As a pre-cleaner, a liberal amount of solvent should be applied and the excess solvent and contaminants wiped from the test surface with a dry, lint free cloth or paper towels. The spray and wiping operation SHALL be repeated until a clean, residue free surface is obtained. Following the application of spray solvent, sufficient dwell period SHALL be allowed to permit evaporation of any residual solvent before applying penetrant. A drying oven will accelerate the evaporation process, significantly reducing the dwell time and SHOULD be used whenever possible.

2.4.5 Penetrant Application.

2.4.5.1 General. This section provides basic, intermediate, and advanced information on the methods and procedures used in applying penetrant to components to be inspected. The first portion of the section contains information related to penetrant application methods. The second portion provides information related to the temperature limitations for application. The third portion covers dwell time requirements and considerations.

2.4.5.2 Penetrant Application Methods.

CAUTION

Care SHALL be taken to avoid trapping air bubbles or pockets during penetrant application to complex shaped parts by immersion. Oil and air passages and blind holes SHALL be plugged prior to penetrant application by immersion. Remove the plugs immediately after the inspection process.

Penetrant can be applied by any of several methods, immersion or dipping, spraying, brushing, swabbing, or flowing. The method to be used depends on several factors, including size, shape, and configuration of the part or area to be inspected, accessibility of the area to be inspected, and availability of inspection equipment. All methods of application are acceptable provided the surface or area to be inspected is completely coated with penetrant, however, there are certain requirements that must be met for each method.

2.4.5.2.1 Immersion/Dipping.

NOTE

When parts are batch processed in a basket, they SHALL be separated from each other during the immersion and dwell period. Contact between parts interferes with the formation of a smooth, even penetrant coating.

Immersion or dipping is the preferred method of applying penetrant when the entire surface of a part must be inspected. The method is limited by the size of the tank or penetrant container. Parts can be immersed one at a time or, if small, can be batch processed by placing them in a basket or rack.

2.4.5.2.1.1 Immersion Considerations.

NOTE

It is difficult or impossible to completely remove penetrant from passages and blind holes following inspection. Therefore, oil or air-cooling passages and blind holes SHALL be plugged or stopped off with corks, rubber stoppers, or wax plugs prior to immersion in penetrant. These devices SHALL be removed immediately after the inspection process.

Certain part configurations require special attention during application of penetrant by immersion. Parts containing concave or recessed surfaces can trap an air bubble or pocket when immersed. Air bubbles or pockets will prevent the penetrant from contacting the part surface. Complex shaped parts SHALL be inverted or turned over while immersed to dislodge any entrapped air. Precautions must also be taken when immersing parts with air-cooling or oil passages and blind holes. During immersion, the passages and holes will fill with penetrant that will bleed out during development and obscure any discontinuity indications in the area. Air cooling passages and blind holes SHALL be plugged prior to immersion.

2.4.5.2.2 Spraying. Penetrant, emulsifiers or removers, and wet developers may be applied by any of several manual or automated spray methods. Spray application is especially suitable for parts too large to be immersed or processed via conveyor lines automated systems. The spray method is also applicable for on-aircraft inspections (portable), and when only a portion or local area of a large part or component requires inspection. In applying penetrant by the spray method, the requirement is to apply a penetrant layer that completely covers the area to be inspected. Spray application of penetrant provides several advantages over the immersion method. It is usually more economical since large tanks of penetrant are not needed, and pooling of penetrant in part cavities is reduced. In immersion application, pooling removes substantial amounts of penetrant by drag out.

2.4.5.2.2.1 Air or Pressure Spray.

WARNING

Paint type respirators SHALL be required when spraying penetrant as determined by the local Base Bioenvironmental Engineering. Additionally, atomized penetrant is very flammable.

Penetrants can be applied from most types of spray equipment using liquid pressure only, air aspiration only, or a combination. The equipment used is similar to that used in spraying paint. It consists of a supply tank, hoses, and a spray gun or nozzle. The supply tank is pressurized to force the penetrant through the fluid hose to the gun. The gun, which may be hand held or mounted in a fixture for automated spraying, is connected to an airline. The air applied to the gun converts the stream of penetrant into a spray. The air pressure, usually between 10 and 90 psig, controls the size of the spray droplets. Too low a pressure may produce a solid stream of penetrant. This would cover only a narrow area requiring many passes to coat the surface, and it also splatters the penetrant on adjacent surfaces. Too high a pressure can atomize the penetrant into a fine fog with poor covering ability and which drifts away from the part. Spray gun application, other than isolated cases, requires a spray booth and exhaust system for confining and reducing overspray.

2.4.5.2.2.2 Electrostatic Spray. The equipment required for electrostatic spraying is similar to that used in air spraying. In addition, a high voltage power supply is connected to the gun. This puts a positive electrical charge on the penetrant particles as they leave the gun. The part is electrically grounded and attracts the charged penetrant particles. The attraction is strong enough to pull the particles to surfaces not in front of or perpendicular to the spray. This ability makes electrostatic spray a preferred method for automated lines where complex shaped parts are to be coated; however, coverage inside cavities is limited. An advantage of the electrostatic spray method is the large savings resulting from reduced material requirements. Electrostatic spraying deposits a thinner layer of penetrant on the part than air spraying and greatly reduces penetrant loss due to overspray. Savings of over 80-percent compared to immersion application have been claimed.

2.4.5.2.2.3 Aerosol Spray. Penetrant packaged in aerosol containers provides a convenient method of application. The advantages and disadvantages to aerosol spray are:

2.4.5.2.2.3.1 Advantages.

- Portability.
- Packaging in sealed containers also eliminates contamination and evaporation of penetrant.
- There is little to no need for special exhaust equipment, as the amount of penetrant involved is small.

2.4.5.2.2.3.2 Disadvantages.

- Aerosol packaging increases material cost.
- Should not be used on large areas due to small spray pattern and high material cost.
- Overspray coats adjacent surfaces and complicates penetrant removal.
- Aerosol cans are known to lose propellant resulting in having to discard unused penetrant.

2.4.5.2.2.3.3 Mixing Aerosol Penetrants.

NOTE

The propellant pressure is directly proportional to the ambient temperature. At temperatures below 60°F (15.6°C), the pressure may be too low for proper spraying. Conversely, the pressure may become excessive and the container may burst if the temperature reaches 120°F (49°C).

Penetrants, unlike nonaqueous developers, do not settle out of solution. Therefore, a mixing ball in the container is not essential; however, some manufacturers buy only a single type aerosol can, which is then used to package penetrant, solvent remover, or nonaqueous developer. Whether the can does or does not contain a mixing ball, it is good practice to shake the can thoroughly before spraying to ensure an even distribution of penetrant and propellant.

2.4.5.2.2.3.4 Applying Aerosol Penetrants. When applying penetrant from an aerosol container, the nozzle should be held 3 to 6-inches from the part surface and the can moved in a line to completely cover the area to be inspected. A thin, even coating with no breaks or non-wetted area is necessary. Excessive penetrant is not desirable as it tends to run or drain off the area and complicates removal. Holding the can motionless or moving it too slowly while spraying will result in an excessive layer of penetrant. Short distances between the can nozzle and the part reduce the size of the spray pattern, and produce a thick layer of penetrant in a small area. Long distances between the nozzle and part increase the size of the spray pattern, and reduce the penetrant layer thickness. There is also an increase in overspray and the possibility of uncovered areas.

2.4.5.2.3 Brush or Swab Application.

CAUTION

Care must be taken to avoid spilling the penetrant while on or in an aircraft or other sensitive locations.

NOTE

Synthetic sponges may dissolve in penetrant.

Penetrant may be applied to large parts by brushing, wiping, or even pouring from a container. The brush or swab method is most frequently used to coat a small area of a large structure. Brushing or swabbing provides control over the placement of penetrant on the desired area, improves the ability to regulate the quantity or thickness of the penetrant layer, and eliminates overspray. Any brush, swab, rag, or even sponge may be used provided the applicator material will not react with the penetrant. The size of the brush may vary from large paint brushes down to small acid or artist brushes, depending on the size of the area to be covered. Any type of clean container may be used to hold the penetrant.

2.4.6 Temperature Limitations.

NOTE

Penetrants may be applied over a range of ambient temperatures; however, certain limits must not be exceeded as the inspection process may be degraded. The operating range for conventional penetrants is 40°F (4°C) to 125°F (52°C). There are special penetrants formulated for hot applications exceeding these limits. Special purpose penetrants are discussed in [Paragraph 2.7](#).

2.4.6.1 Low Temperature Limitations.

NOTE

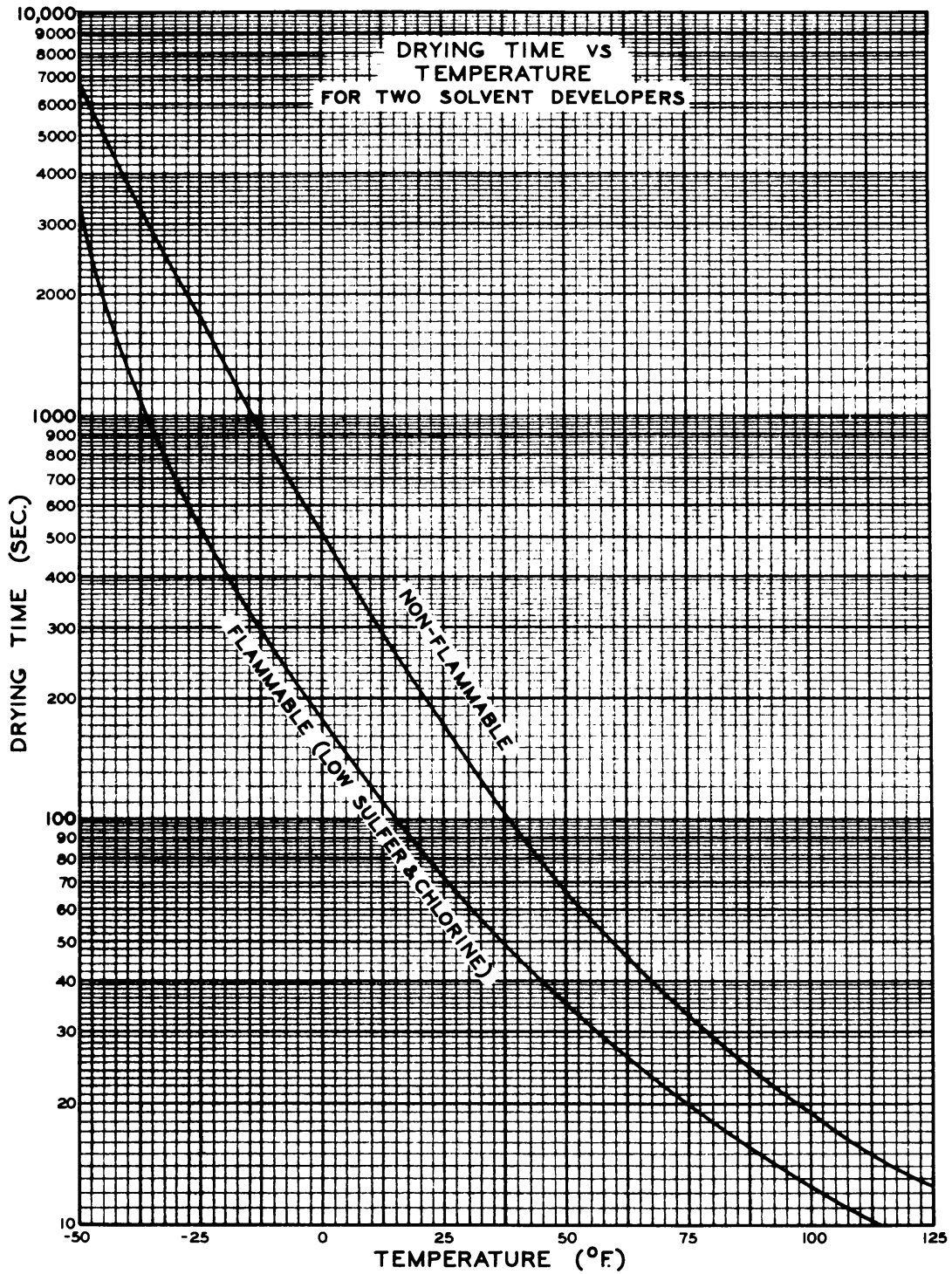
Penetrant inspection SHALL NOT be performed when the test part temperature is less than 40°F (4°C). Reasons for this restriction are:

2.4.6.1.1 At 32°F (0°C) or less, any moisture, even from the inspector's breath, will form ice crystals on the part, which will interfere with the penetration process.

2.4.6.1.2 The propellant pressure in aerosol containers is affected by temperature. The gas pressure decreases with lower temperatures. When the temperature drops below 60°F (15.6°C), the reduced pressure can result in an erratic spray pattern.

2.4.6.1.3 The evaporation rate of solvent cleaners and nonaqueous developers is reduced at lower temperatures. The evaporation or drying time for two types of nonaqueous developers at various temperatures is shown in [Figure 2-17](#). The graph shows a ten-fold increase in drying time between the temperatures of 60°F (15.6°C) and 0°F (-18°C).

2.4.6.1.4 Viscosities of penetrants increase as the temperature decreases. When temperatures are between 40°F (4°C) and 60°F (15.6°C), the penetration dwell time SHALL be increased in accordance with [Paragraph 2.4.7.4.2](#), [Table 2-2](#) due to the increased viscosity. The increase in solvent cleaner evaporation time, penetrant dwell time, and developer drying time required at temperatures lower than 40°F (4°C), makes the total inspection time far too long to be practical.



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Figure 2-17. Graph Showing the Approximate Drying Times for Two Types of Nonaqueous Developers at Various Temperatures

2.4.6.2 High Temperature Limitations.

WARNING

The disadvantages of elevated temperatures outweigh the advantages. Penetrant application and dwell SHALL NOT be initiated on parts where temperatures exceed 125°F (52°C), unless special high temperature penetrants are used.

Sensitivity is improved slightly when test part temperatures are 125°F (52°C) to 150°F (65.5°C). The higher temperature evaporates some of the liquid, which increases the dye concentration and improves the visibility of indications. The elevated temperature also reduces viscosity, which speeds penetration. At temperatures of 125°F (52°C), the volatile components of penetrants are rapidly evaporated. During penetrant dwell, the layer of penetrant is very thin and with a part temperature of more than 125°F (52°C), the loss of volatile components will drastically change the penetrants composition. Elevated temperatures also reduce visible dye color and fluorescence (heat fade), making indications less visible. In general if a part is too hot to handle, it is too hot for penetrant testing.

2.4.7 Penetrant Dwell.

2.4.7.1 Definition of Penetrant Dwell. Penetrant dwell is the total length of time the penetrant is allowed to remain on the part before removal of the penetrant. This includes immersion, soak, and drain times. The purpose of dwell is to allow the penetrant to seep into and fill any surface openings.

2.4.7.2 Factors Influencing Penetrant Dwell Time. There are a number of interacting factors that influence the length of time required for penetrant to enter and fill a surface void. Some of the factors are listed below with a description of each following: void size (geometry and volume), penetrant sensitivity, part material and form, discontinuity type, discontinuity contamination, insoluble soil contamination, and soluble soil contamination.

2.4.7.2.1 Void Size. The dwell time required for a penetrant to enter and fill a surface void depends mainly on the width of the surface opening and depth of the void. Penetrant enters and fills voids with wide openings more rapidly than those with narrow openings. Very narrow or tight flaws, such as those associated with fatigue cracking, may require 2 to 5 times the length of dwell time compared to a wider flaw such as a crack caused by over-stressing. The larger void depth requires more time to fill because there is more volume within the void.

2.4.7.2.2 Penetrant Sensitivity. The sensitivity of a penetrant inspection is affected by the length of penetrant dwell time. The differences in dwell times are due to the differences in surface tension, contact angle, and viscosity of the various penetrant types and sensitivities. While material viscosity between manufacturers of the same type and sensitivity level vary, the combination of factors tends to stabilize dwell time for each type and sensitivity. This allows penetrants within each of the sensitivity levels to have equivalent dwell times.

2.4.7.2.2.1 Sensitivity Selection. Selection of the sensitivity level to be used depends on a number of factors: potential flaw size, width of opening, volume of the discontinuity, part size, part shape, surface finish, residual stress, allowable flaw size, and intended service of the part. The rule-of-thumb is to use the highest sensitivity possible to reveal critical discontinuities while at the same time ensuring complete removal of all surface penetrant to reduce or eliminate background. Difficulties can be experienced if the sensitivity level is either too low or too high. Low sensitivity levels may not reveal critical flaws, while excessive sensitivity can result in an excessive residual background that would obscure any discontinuity indications or produce nonrelevant indications. The required penetrant sensitivity level used for an inspection should be specified in the part specific inspection procedure or technical data. It is permissible to use one sensitivity level higher than specified provided that background fluorescence is not excessive and does not hinder evaluation of the inspection surface. When the sensitivity level is not defined within the technical data a minimum of Level 3 sensitivity SHALL be used.

2.4.7.2.3 Part Material and Form. The effect of part material (steel, magnesium, aluminum, etc.) and form (castings, forgings, welds, etc.) on penetrant dwell relates to the type of flaw typically found. For example, cold shuts in steel castings tend to have tighter openings than cold shuts in magnesium castings. Therefore, the dwell times for cold shuts in steel castings are typically longer than the dwell times in magnesium and aluminum castings. Discontinuities occurring in forgings are typically tighter than in castings and require longer dwell time.

2.4.7.2.4 Discontinuity Type. The various types of discontinuities differ in the width of the opening. Laps are tighter than porosity, and fatigue cracks are tighter than either laps or porosity. The required length of penetrant dwell increases as the discontinuity width decreases (surface opening becomes tighter or narrower).

2.4.7.2.5 Discontinuity Contamination. Penetrant dwell times are based on clean parts without entrapped contaminants. Inspection of parts that have been in service can be complicated by the difficulty of removing all of the entrapped soil from the discontinuities. The effect of the entrapped soil on the penetrant dwell time depends upon the type and amount of soil involved.

2.4.7.2.6 Insoluble Soil Contamination. If the discontinuity is full of soil, is not soluble in penetrant, penetration cannot occur. A change in penetrant sensitivity or dwell time will not help since penetrant cannot enter such flaws. A discontinuity only partially filled with insoluble soil will produce a smaller and less visible indication. Increasing the dwell time will not improve the indication; however, a more sensitive penetrant with its higher dye content will produce a more visible indication.

2.4.7.2.7 Soluble Soil Contamination. When discontinuities contain soils soluble in penetrants, such as un-pigmented grease, oils, cleaning solutions and other soluble organic materials, penetration of the inspection fluid into the discontinuity can occur. The penetrant will fill any vacant space in the discontinuity and then stop. Diffusion then begins between the penetrant and soluble soil. In a short time, the penetrant and soil become mixed; however, this mixture will fluoresce much less and may not give a useful indication. An increase in dwell time will improve the visibility of the indication. With increased dwell time some of the soil diffuses out of the discontinuity and is replaced with pure penetrant. Using a more sensitive penetrant will improve the visibility of the indication since the higher dye content can withstand more dilution.

2.4.7.3 Affects of Temperature and Viscosity on Dwell Time.

2.4.7.3.1 Penetrant Viscosity Vs. Temperature Change. Viscosity of oils, which includes penetrants, changes drastically with temperature. Oils become thin (less viscous) at high temperatures and thick (more viscous) at low temperatures. How the viscosities of a number of penetrants change with temperature is illustrated in [Figure 2-18](#). The horizontal and vertical scales are spaced to show the viscosity changes as a straight-line function. This chart also shows that the viscosity of a high sensitivity, postemulsifiable (PE) penetrant is about 3 centistokes (cs) at 120°F (49°C) and about 75 cs at -10°F (-23°C), or becomes about 25 times thicker. The same chart shows the viscosity of visible dye is about 2 cs at 120°F (49°C) and 22 cs at -10°F (-23°C), which is an eleven times increase in viscosity. The required part temperature range for applying penetrants is 40°F (4°C) to 120°F (49°C). Most penetrants are applied at or near a part temperature of 70°F (21°C). Therefore, nearly all operating instructions or procedures specifying dwell times are based on applying penetrant to a part at or near a temperature of 70°F (21°C). The viscosity of a typical high sensitivity postemulsified penetrant (7 cs) at 70°F (21°C) is twice the viscosity (14 cs) at 40°F (4°C) and about half the viscosity (3 cs) at 120°F (49°C). Other penetrants show a similar range of viscosity change with temperature. These viscosity changes are significant enough to require the adjustment of dwell times for temperature extremes.

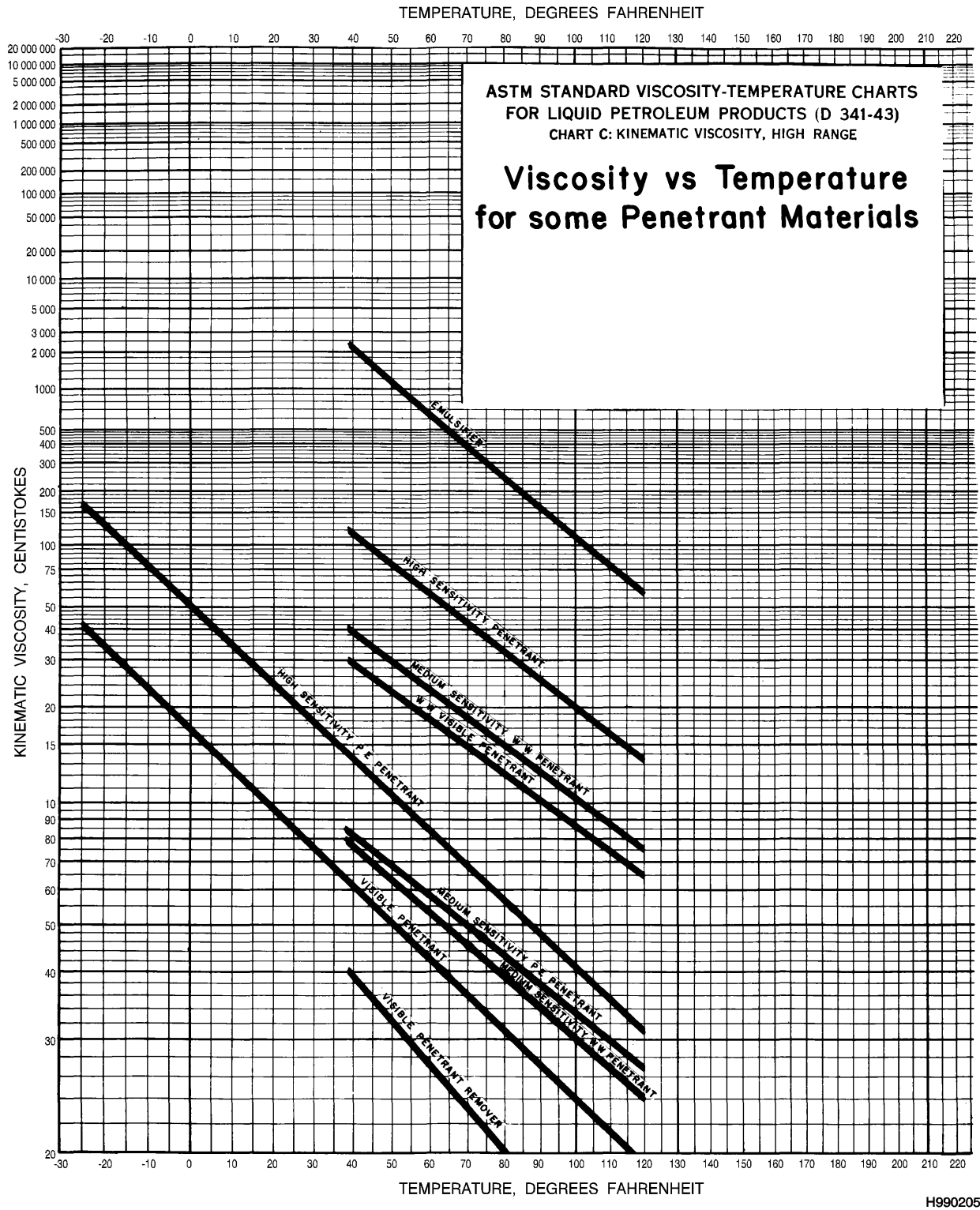
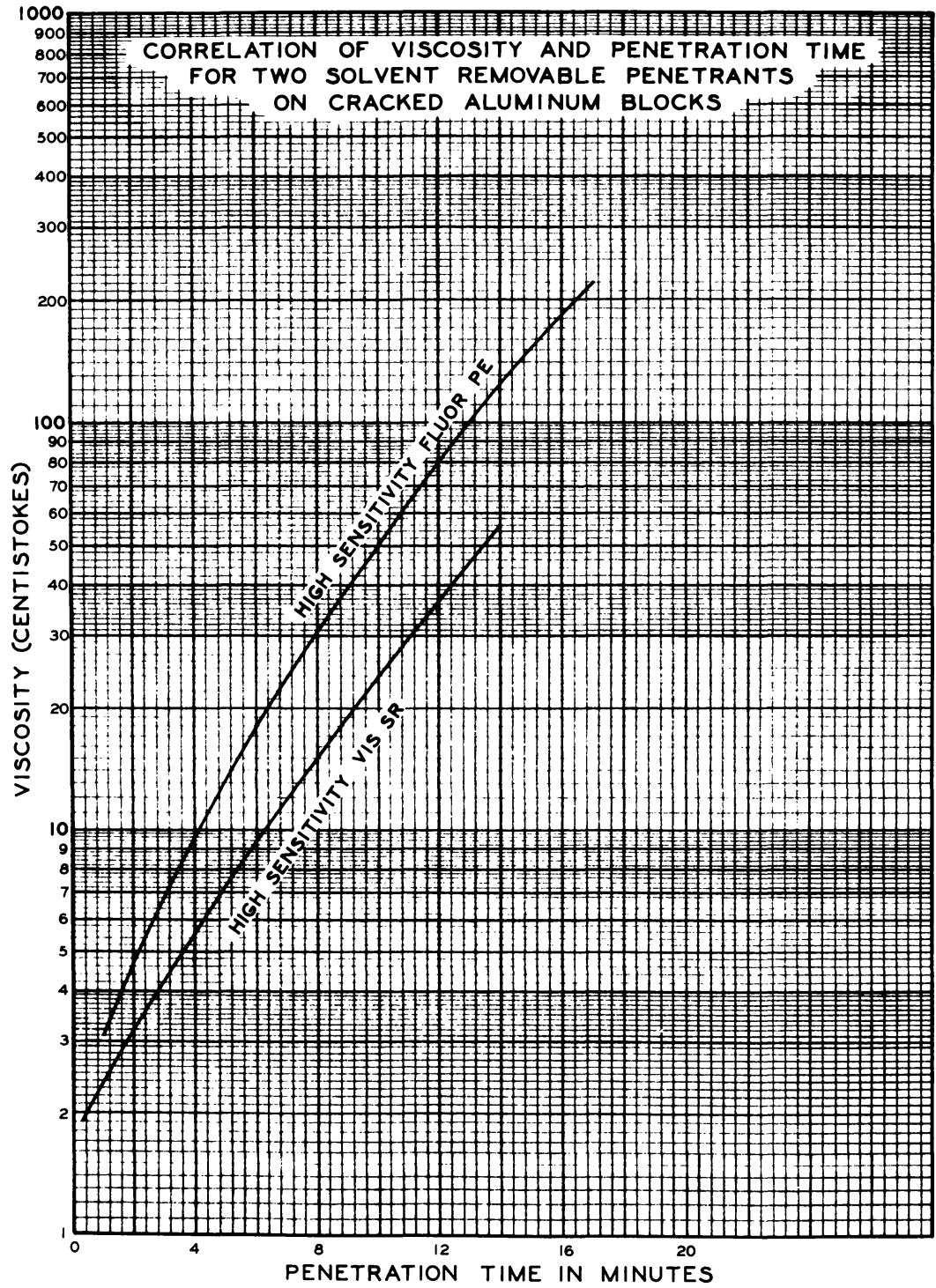


Figure 2-18. Graph Showing the Viscosities of Several Quality Parts Listing (QPL) Penetrants at Various Temperatures



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Figure 2-19. Graph Showing the Comparison of Dwell Time Vs. Viscosity for Two Types of Penetrants

2.4.7.3.2 Dwell Time Vs. Temperature and Viscosity.

NOTE

The evaporation rate of penetrant is increased at temperatures above 100°F (37.2°C). Care SHALL be taken to prevent the penetrant from drying.

Laboratory experiments have demonstrated penetrant dwell time does not have to be changed in the same ratio as the viscosity changes. The minimum dwell times for the penetrants previously discussed is compared in [Figure 2-19](#). The high sensitivity PE penetrant, with a viscosity of 7 cs at 70°F (21.1°C), required a penetrating time of 3 minutes. At 40°F (4°C), the viscosity doubled to 14 cs, while the dwell time increased by 1.75 to 5.5 minutes. At 120°F (49°C), viscosity of penetrant drops to less than one-half (3 cs) and the dwell time decreases by two-thirds (1 minute). The thinner visible-dye penetrant, with a viscosity of 3.6 cs at 70°F (21.1°C), required a penetrant dwell time of 2.4 minutes. At 120°F (49°C), the viscosity was reduced by almost one-half (2.0 cs), while the required dwell was reduced to one-fifth of the time (0.5 minutes).

2.4.7.4 Penetrant Dwell Characteristics.

2.4.7.4.1 Dwell Modes. There are two basic penetrant dwell modes, "immersion" and "drain."

2.4.7.4.1.1 Immersion Dwell Mode. In this mode the part remains submerged in a tank of liquid penetrant for the entire dwell period. Immersion dwell can also be performed by continuously brushing with fresh penetrant throughout the dwell period.

2.4.7.4.1.2 Drain Dwell Mode.

NOTE

Drain dwell is the preferred mode and SHALL be used unless the inspection instruction specifies immersion dwell.

With drain dwell, the part is first covered with penetrant by spraying, brushing, or immersion. Once coated, the part is placed on a rack or rest and allowed to drain during the dwell period. Comparison tests with aluminum crack blocks and nickel-chrome penetrant panels have demonstrated the improved performance of drain dwell mode compared to immersion dwell mode. This improved performance is due to the changes in penetrant composition that occurs during the dwell period. The penetrant vehicle is a mixture of heavy oils that dissolve and hold the dye materials in solution; and thin or lightweight solvents or oils that reduce the viscosity of a penetrant. During the drain dwell period, the lighter weight liquids evaporate, which increases the concentration of the dye material entrapped in discontinuities. The increased dye concentration enhances the visibility of the indication. The drain dwell mode is also more economical than immersion dwell mode since the excess penetrant drains from the part and is recovered. The savings with drain dwell are two-fold, since the drained penetrant is recovered and the remaining penetrant layer is much thinner than an immersion dwell layer. The thinner penetrant layer requires less emulsifier during the removal process. Generally, the immersion is momentary, but at most, it should be no longer than half the total dwell period.

2.4.7.4.2 Minimum Penetrant Dwell Times.



The minimum dwell time for service-induced defects SHALL NOT be less than 30-minutes, unless otherwise specified by a specific part procedure.

NOTE

Selection of a penetrant dwell time is complex and depends upon a large number of factors. A thorough knowledge of the penetrant capabilities and limitations of the penetrant system used for the type of discontinuity to be detected is required. Whenever possible, the decision of dwell time should be based upon experience of the responsible engineering support. Documents governing dwell time SHALL specify the mode and time of dwell. The number of factors influencing the entry of penetrant into a discontinuity complicates setting uniform minimum penetrant dwell times.

Most dwell times are based on past experience with similar parts, materials and potential flaws. The minimum penetrant dwell time that SHALL be used is provided in [Table 2-2](#). These dwell times are based on the expected flaw condition and ambient temperature conditions. Minimum penetrant dwell times for manufacturing induced defects SHALL be as specified by ASTM E1417 or as specified by specific technical directive or procedures. Minimum penetrant dwell times SHOULD be specified in the technical directives or part specific procedures mandating the inspection.

Table 2-2. Minimum Penetrant Dwell Times

Temperature 40° - 60°F	Minimum
Service Damage/Fatigue Cracks	60 minutes
Stress Corrosion Cracks	240 minutes
Temperature 60° - 125°F	Minimum
Service Damage/Fatigue Cracks	30 minutes
Stress Corrosion Cracks	240 minutes

2.4.7.4.3 Effects of Insufficient Dwell. When the dwell time is too short to allow the penetrant to completely fill the discontinuity, the visibility of the resulting indication will be reduced. A thermally cracked, aluminum block with one half receiving an adequate dwell, and the other half an insufficient dwell is shown in [Figure 2-20](#). The differences in dwell times have different effects depending on the flaw size. The very small flaws are not indicated, the visibility of indications from medium size flaws is greatly reduced, and there is a slight reduction in the visibility of larger size flaw indications. If it is suspected a part has not had an adequate dwell, the part SHALL be completely cleaned and then reprocessed through the entire inspection process.

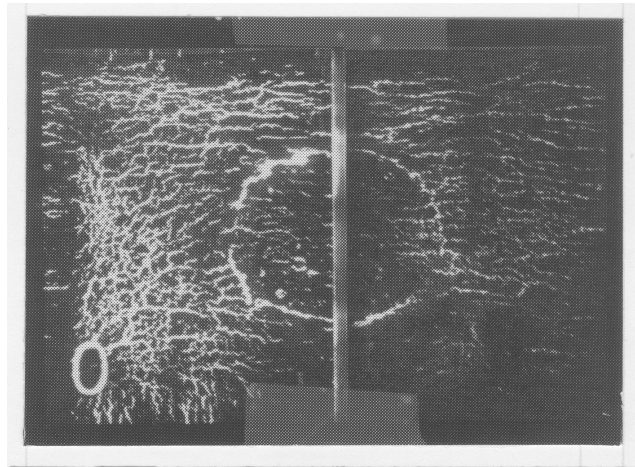


Figure 2-20. Comparison of Adequate Dwell Vs. Insufficient Dwell on a Thermally Cracked Aluminum Block

2.4.7.4.4 Effects of Excessive Dwell.

NOTE

Fresh penetrant SHALL be applied at 60-minute intervals when dwell time exceeds 60 minutes or when the penetrant appears to be drying on the part. The penetrant SHALL NOT be allowed to evaporate to the tacky or dry state while on the part. If, for some reason, the penetrant is allowed to become tacky, the part SHALL be subjected to a complete reprocessing through the pre-cleaning and penetrant inspection cycle.

Once the penetrant has completely filled a void, extending the dwell time will not improve the indication; except for the case of the contaminated flaw. Application of fresh penetrant improves the rate of penetration and makes it easier to remove the excess surface penetrant at the end of the dwell period. Evaporation is accelerated by temperatures above 100°F (38°C) or by rapid air movement. When inspections require excessively long penetrant dwell times, another inspection method, such as eddy current, may be considered to reduce inspection time.

2.4.8 Penetrant Removal. This section provides basic, intermediate, and advanced information on the methods and procedures used in removing excess surface penetrant. The first portion of the section contains general information applicable to all removal methods. The second portion is devoted to the water washable penetrant processes and water washing or spray rinsing. The remaining portion covers the methods and procedures used in the postemulsifiable lipophilic, postemulsifiable hydrophilic, and solvent removable penetrant processes.

2.4.8.1 After the penetrant has been applied and has filled any open discontinuities, the excess penetrant on the surface SHALL be removed. Removal of the excess surface penetrant is a critical step in the inspection process. Improper removal can lead to misinterpretation and erroneous results. Excessive or over-removal will reduce the quantity of penetrant entrapped in a flaw, resulting in either a failure to produce an indication or an indication with greatly reduced visibility. Incomplete or insufficient removal will leave a residual background that may interfere with the detection of flaw indications. The term “removability” applies to the ease of removing the excess surface penetrant. “Washability” is sometimes used interchangeably in commercial application; however, the materials specification and this manual will use “washability” only in the case of water-washable penetrants.

2.4.8.2 Factors Influencing Penetrant Removal.

2.4.8.2.1 Part Surface Condition. The surface condition of the part has a direct effect on removability. Smooth, polished surfaces such as chromium-plated panels can be easily processed by any of the removal methods with no residual background. As the surfaces become rougher, such as chemically etched or sand blasted parts, the removal of surface penetrant becomes more difficult. Rough surfaces reduce removability in two ways 1) The roughness restricts the mechanical force of the spray rinse in the indentations or low points and 2) the roughness prevents the emulsifier from evenly combining with the surface penetrant. It is not always possible to produce a background-free surface on rough parts. The wash or emulsification

time required for a completely clean surface may result in removal of some of the penetrant entrapped in flaws. In this case, the wash or emulsification time may be shortened, leaving some residual background. The amount of residual background SHALL be limited to allow any flaw indications to be visible through the background.

2.4.8.2.2 Part Shape or Geometry. The part shape and geometry may indirectly affect removability by causing a thicker layer of penetrant to accumulate during the dwell period and restrict accessibility to the test surface by the spray rinse. One of the factors involved in removing excess surface penetrant is the mechanical action or force of the spray rinse. When parts contain surfaces where the spray cannot directly strike the surface, such as concave or recessed areas, holes, and screw threads, the removal time is increased in these local areas. Also, the thickness of the penetrant layer in these inaccessible areas is usually greater than on the adjacent surfaces. This is due to the tendency of the penetrant to drain and collect in these areas. For example, during the dwell period the penetrant will drain from the top or crown of a thread and will flow into the thread root area. The increased layer thickness in the thread root requires a longer removal time than the thin layer at the thread crown. The inaccessible surfaces usually have thicker layers of penetrant and require additional removal time. Care SHALL be exercised to prevent over-removal on the accessible surfaces with thinner penetrant layers, while trying to adequately clean the thicker penetrant layer from an adjacent inaccessible surface.

2.4.8.2.3 Narrow Deep Flaws. Flaw size and shape may complicate the removal process. Narrow, deep flaws, while requiring long penetrant dwell times, provide a relatively large reservoir to hold entrapped penetrant. The narrow surface opening reduces both the diffusion rate of emulsifier into the flaw and the effect of mechanical force of the spray rinse on the entrapped penetrant. The result, narrow, deep flaws produce highly visible indications with a minimum of removal problems.

2.4.8.2.3.1 Narrow, Shallow Flaws. The removal process becomes slightly more critical when narrow, shallow flaws are present. Narrow, shallow flaws do not have a large reservoir to hold entrapped penetrant. The visibility of an indication depends on the amount of penetrant that exits from the flaw. If the flaw is shallow, only a small amount of penetrant is available, and the indication may be faint. Over-removal of any entrapped penetrant will reduce the visibility of an already faint indication. In addition, a small amount of residual background (insufficient removal) will obscure faint indications.

2.4.8.2.3.2 Broad, Shallow Flaws. Broad, shallow flaws are defined as those with the surface opening equal to or greater than the depth. They present the most critical case for penetrant removal. The opening does not reduce the force of the spray rinse, nor does it restrict the emulsification rate, and entrapped penetrant is easily removed. Extreme care must be used during penetrant removal if broad, shallow flaws are likely to be present.

2.4.8.3 Removability Properties of Penetrant. Penetrant materials vary widely in their ease of removal. There are differences in removability between the various penetrant types, classes, and sensitivity levels. Also, similar penetrants provided by different manufacturers vary in removability. One penetrant characteristic affecting removability is the viscosity. High viscosity (thick) penetrants are more difficult or more slowly removed than low viscosity (thin) penetrants. The penetrant system sensitivity level also affects removability. Higher system sensitivity level penetrants contain more dye per unit volume, and trace quantities of residual penetrant will produce a higher background than the same quantity of a penetrant system with a lower sensitivity level. It is necessary to remove more of the residual high sensitivity penetrant to produce an equivalent background.

2.4.8.4 Removal of Water Washable (Method A) Penetrants.

CAUTION

Water washable (Method A) penetrants are prohibited for use on all flight critical aircraft components, and on all engine components. Water washable penetrants SHALL NOT be used on these components without specific written authority from the responsible engineering authority.

NOTE

Water washing of fluorescent penetrant SHALL be accomplished under UV-A illumination. The wash station should be in subdued light, if possible (less than 20 lumens).

Water washable penetrant is removed after penetrant dwell by subjecting the part to a water spray wash. The spray wash may be a hand-held nozzle, a semi-automatic system, or a fully automated system. Care SHALL be exercised to prevent over-removal since the penetrant entrapped in discontinuities contains an emulsifying agent and is easily removed. Removal is con-

trolled by length of wash time and the wash SHALL be stopped when an acceptable background is reached. Cracked- chrome panels, following different wash times is shown (Figure 2-21). Insufficient wash, optimum wash, and excessive wash are shown. The smooth surface of the chrome-plated panel is deceptive. If the surface were rougher, some residual background may have been retained on the optimum-wash sample. See Section 2.4.9 for proper rinse procedures.

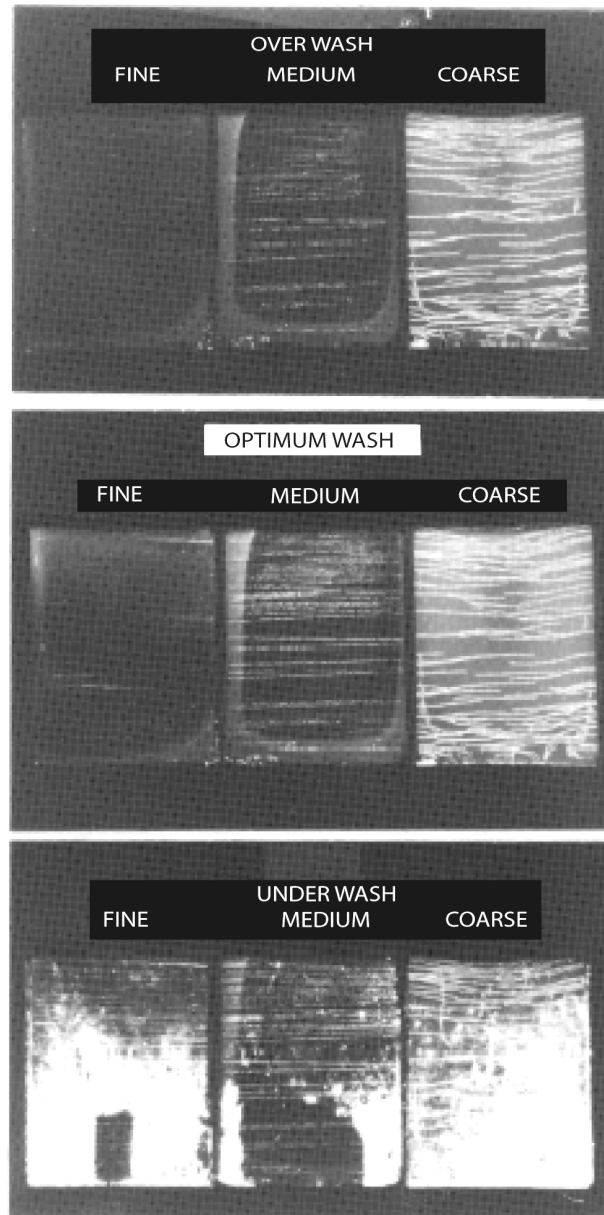


Figure 2-21. Cracked-Chrome Panels Showing Effects of Insufficient Wash, Optimum Wash, and Excessive Wash

2.4.8.4.1 Advantages of Water Washable, (Method "A") Penetrant. Water Washable, Method "A", penetrants have several advantages over other methods:

- Elimination of the separate emulsification process step results in cost savings:
 - The cost of the combined penetrant emulsifying agent is less than the total cost of separate penetrant and separate emulsifier.
 - A separate tank or station for emulsifier is not required.
 - Cost of automating is reduced.
 - Process flow time, especially on volume is reduced.
- The emulsifiable mixture is easily removed from complex shaped parts, making it advantageous for use on threads and keyways.
- The variables associated with controlling emulsifier dwell time are eliminated.

2.4.8.4.2 Disadvantages of Water Washable, (Method "A") Penetrant. Water Washable, Method "A", penetrants also have disadvantages:

- There is no control over the diffusion or emulsified layer. Penetrant entrapped in flaws contains emulsifying agent, making it susceptible to removal by over-washing. It is also easily removed from broad, shallow flaws.
- Water rinse time is critical and SHALL be carefully controlled.
- Residual background is higher than from the same sensitivity level postemulsifiable penetrant system.
- The penetrant emulsifying agent mixture is susceptible to water contamination.
- Treatment or disposal of large quantities of rinse water contaminated with water washable penetrant is required.

2.4.8.5 Comparison of Lipophilic, Method "B" and Hydrophilic, Method "D" Penetrants.

CAUTION

Post-emulsifiable lipophilic (Method "B") penetrants are prohibited for use on all rotating engine components without specific authorization from the responsible engineering authority.

The main difference between methods "B" and "D" is not in the penetrant material, but in the process used to remove the penetrant. Unlike Method "A" penetrant materials, which have a built-in remover action, the removability action is aided by emulsifier or remover. Close attention SHALL be given to knowing which method you are using and the advantages and disadvantages to using both.

2.4.8.5.1 Both Method "B" (Lipophilic) and Method "D" (Hydrophilic) penetrants are oil-based vehicles containing highly visible colored or fluorescent dyes. They are formulated to optimize their penetration and visibility capabilities. They differ from water washable penetrant in they resist removal by water washing since they do not contain an emulsifier. A separate process step of emulsification is required for removal.

2.4.8.5.2 Lipophilic Emulsifier Versus Hydrophilic Remover Processes. Differences between the lipophilic and hydrophilic processes are summarized as follows:

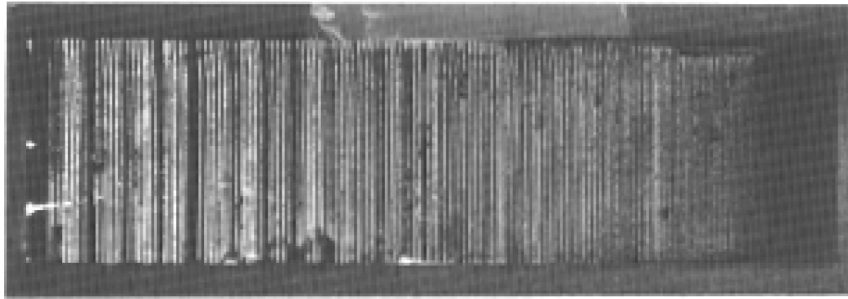
- Lipophilic emulsifier is supplied as a ready to use liquid, whereas hydrophilic remover is supplied as a liquid concentrate, which must be diluted with water before use.
- The hydrophilic process requires an additional pre-rinse step immediately following the penetrant dwell period.

- The methods of applying the emulsifier and remover differ. Parts are dipped into lipophilic emulsifier and then immediately removed to drain. Parts either are immersed into hydrophilic remover for the entire removal time or are subjected to a spray of remover for the specified time.
- The modes of action by which the lipophilic emulsifier and hydrophilic remover remove the excess penetrant differ.

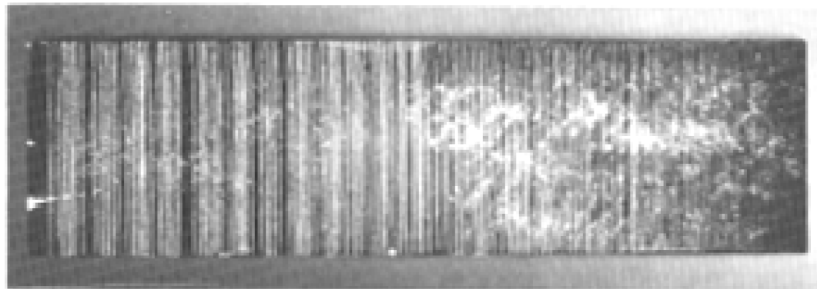
2.4.8.5.3 Advantages of Using Hydrophilic Removers Over Lipophilic Emulsifiers. A comparison of the physical, chemical, and application differences between the hydrophilic and lipophilic techniques is provided in [Table 2-3](#). There are several benefits to using the hydrophilic method over the lipophilic method. The hydrophilic process has the ability to remove surface penetrant with reduced effect on penetrant entrapped in a crack. Another major advantage of hydrophilic removers is the increased process tolerance (e.g., hydrophilic removal time is not as critical as lipophilic emulsification dwell). Hydrophilic removal times of 1 or 2-minutes have little effect on penetrant entrapped in a discontinuity, while exceeding the maximum lipophilic emulsification times by as little as 10 or 15-seconds can seriously degrade a flaw indication. A cracked-chrome plated panel processed to show the effects of optimum, insufficient, and excessive hydrophilic removal ([Figure 2-22](#)). The cracks in the panel are progressively smaller from left to right in the figure. Another advantage to using hydrophilic remover is the relative insensitivity to removal of penetrant entrapped in a discontinuity. This permits complete removal of fluorescent background in most cases. In contrast, when using lipophilic emulsifier on slightly rough surfaces, it is desirable to leave a faint residual background when maximum sensitivity is required. The reduction of background fluorescence with the hydrophilic remover improves the contrast, making faint indications easier to see. The hydrophilic method also allows spot touch-up removal on local areas during the final clear water rinse. Spot touch-ups cannot be done with the lipophilic method, since the oil base emulsifier will not tolerate water. Hydrophilic removers also provide better control, handling, and recycling of the process materials. This can significantly decrease wastewater treatment costs and minimize water pollution.

Table 2-3. Comparison of Hydrophilic Vs. Lipophilic Methods

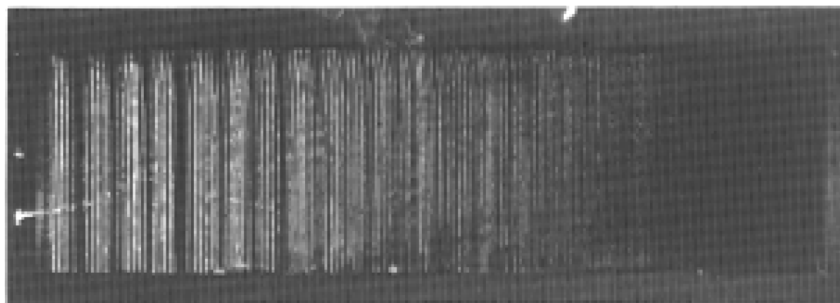
Hydrophilic	Lipophilic
1. Supplied as a concentrate	1. Supplied as a ready to use fluid
2. Water base when mixed	2. Oil base
3. Low viscosity 9 to 12 cs	3. High viscosity 35 to 120 cs
4. Limited penetrant tolerance	4. Miscible with penetrant in all concentrations
5. Miscible with water in all concentrations	5. Limited water tolerance
6. Applied as dip or spray	6. Applied as a dip
7. Action: Dip-detergent with scrubbing wash	7. Action: Diffusion activated by scrubbing
8. Reduced drag-out	8. Critical emulsion time



OPTIMUM REMOVAL



UNDER REMOVAL



OVER REMOVAL

Figure 2-22. Effects of Optimum, Insufficient, and Excessive Hydrophilic Removal Dwell Time

2.4.8.6 Removal of (Method "B") Penetrants with Lipophilic Emulsifier.

2.4.8.6.1 Using Lipophilic Emulsifier (Method "B").

NOTE

When the part surface has been coated with emulsifier, the part SHALL be removed from the liquid and allowed to drain. The part SHALL NOT remain in the emulsifier during the dwell period.

Refer to [Figure 2-14](#). Lipophilic emulsifier is applied, after a sufficient penetrant dwell time, by dipping or immersing the part in a tank of emulsifier. Lipophilic emulsifier is used as supplied by the manufacturer. Application of the material SHALL NOT be accomplished by spraying, flowing, brushing, or wiping onto the part. The two major problems with spraying and flowing are the difficulty in applying a uniform thickness and the difficulty of applying enough emulsifier without the mechanical force of the spray scrubbing the penetrant layer. Brushing or wiping on material produces an uncontrolled and uneven mixing action. There are a few automated systems where the emulsifier is applied as a fog.

2.4.8.6.2 Lipophilic Emulsifier Dwell.

CAUTION

Dwell time is critical in this process and SHALL be monitored closely to avoid over-emulsification.

After the emulsifier has been applied and the part is draining, a period of time is allowed for diffusion of the materials. During diffusion, a water removable colloidal mixture is being formed. This is the emulsifier dwell time and is one of the most critical factors in the lipophilic process. A timing device is required to control this process. The objective is to stop the diffusion when the emulsifier has just reached the part surface and before it diffuses into any penetrant entrapped in a discontinuity. Penetrant without emulsifier resists removal. If the dwell time is too long, the emulsifier will diffuse into entrapped penetrant easily removed causing loss of sensitivity and missed flaws. If the time is too short, the thin layer of surface penetrant not emulsified will cause an excessive background that can obscure a discontinuity indication. A number of factors which influence the dwell times are discussed in the following paragraphs.

2.4.8.6.3 Factors Influencing Lipophilic Emulsifier Dwell Time.

2.4.8.6.3.1 Part Surface. Very smooth polished surfaces retain only a thin layer of penetrant and require a relatively short emulsifier dwell period. On the other hand, longer emulsifier dwell times are required for rough surfaces, which retain a thicker layer of penetrant. Inspections of components with rough surfaces, such as sand castings, dictate a longer time for the emulsifier to diffuse to the bottom of the surface indentations.

2.4.8.6.3.2 Flaw Type. Tight flaws, with significant depth relative to flaw width, are more tolerant to longer emulsification dwell time than are wide, shallow flaws. The diffusion rate of even the more active emulsifiers is slowed down when diffusing into constricted or narrow openings. The diffusion rate on wide, shallow flaws can be rapid and it is easy to over-emulsify. Some over emulsification can be tolerated with deep flaws, which provide large reservoirs for entrapped penetrant. A degree of under-emulsification (or residual background) may be required when detection of shallow flaws in parts with rough surfaces is required.

2.4.8.6.3.3 Penetrant Dwell Time. Long penetrant dwell times permit more penetrant to drain from the part, resulting in a thinner surface layer. Since diffusion rate for a given emulsifier is constant, the emulsifier dwell time required is proportional to the thickness of the penetrant layer (e.g., thicker layers require more emulsification dwell time, and thinner layers require less time).

2.4.8.6.3.4 Emulsifier Contamination. As parts are processed, the emulsifier becomes contaminated with penetrant from both the initial immersion and the drain cycle. While penetrant and emulsifier are soluble in all combinations, the gradual increase of penetrant in the emulsifier slows the emulsification action. With combined build-up, the mixture will eventually stop functioning as an emulsifier. The slowing action due to penetrant contamination is very gradual, and at concentrations of less than 25-percent (penetrant in emulsifier) the performance of the emulsifier is generally not affected.

2.4.8.6.4 Determining Lipophilic Emulsification Dwell Time.

CAUTION

- The lipophilic emulsion step does not tolerate deviation from the optimum dwell time. A relatively short over-emulsification time of 10-seconds on a 1-minute dwell period can result in failure to indicate small flaws.
- Emulsifier dwell time SHALL NOT exceed 5-minutes.

Although emulsifier dwell time is critical for most defects, the large number of influencing factors make it impossible to develop a general dwell timetable. Optimum emulsifier dwell time must be determined on each part by experiment, even here, dwell times may require adjustment to compensate for local conditions. At the extreme, dwell times may range from 10-seconds to 5-minutes; however, typical dwell times of less than 1-minute are adequate. Cracked-chrome plate panels and the effects of insufficient, optimum, and excessive emulsifier dwell are shown in [Figure 2-23](#).

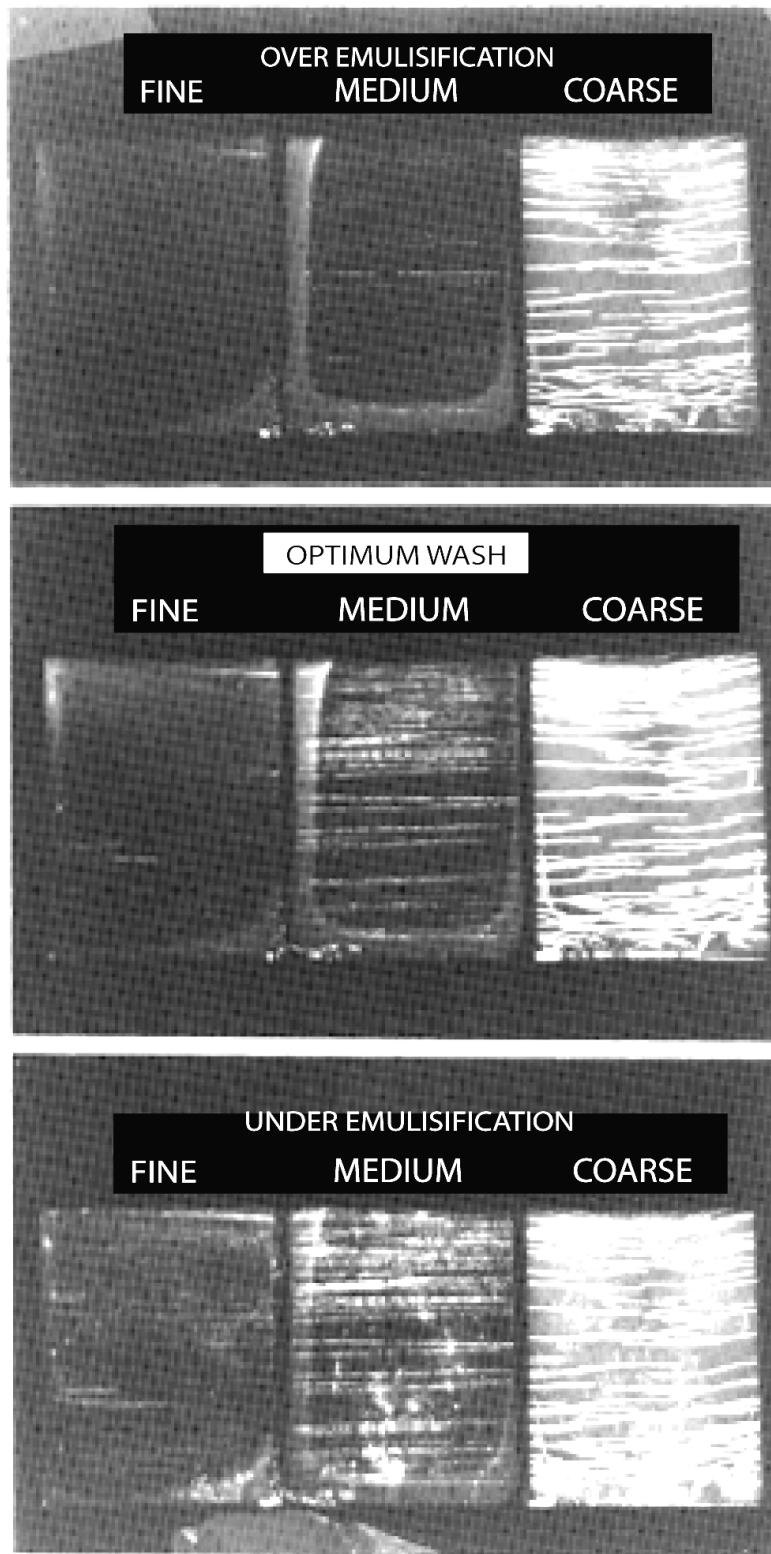


Figure 2-23. Effects of Optimum, Insufficient, and Excessive Emulsifier Dwell Time

2.4.8.6.5 Rinse - Stopping the Emulsification Action.

CAUTION

- Postemulsifiable penetrant entrapped in flaws and not diffused with emulsifier is relatively resistant to water spray and rinse time is not critical, however, excessive spray pressure or hot water can remove entrapped penetrant and SHALL be avoided.
- For an agitated immersion rinse, the dwell time SHALL be the minimum required to remove the emulsified penetrant. Examine the components under appropriate illumination after rinsing. Clean and reprocess those parts exhibiting excessive background.
- The air nozzle SHALL be held at a sufficient distance from the part to ensure the developing indication is not smeared by the air blast.

After the appropriate dwell time, emulsification SHALL be stopped by agitated immersion or water rinse. If rinsing is used an initial light water spray over the entire surface of the part SHALL be performed. This initial rinse stops the diffusion process and eliminates excessive emulsifier dwell on any surface. Further water spraying to remove the excess emulsified surface layer is performed only after the entire surface has been wetted and the diffusion process has been stopped. After rinsing, allow the water to drain from the component. Utilize repositioning, suction, blotting with clean absorbent materials or filtered shop air at less than 30 psi to prevent pooling of water. See Section 2.4.9 for proper rinse technique.

2.4.8.6.6 Batch Processing Using Lipophilic Emulsifier.

CAUTION

When a number of parts are being inspected, they SHALL be processed one at a time through the emulsifier, emulsifier dwell, and wash steps unless they are small enough to be batch processed.

Because emulsification time is critical for the Method B process, the dwell time for each part SHALL be closely monitored. Excessive dwell will occur when emulsifier is applied to a number of individual parts and they are then individually washed. Batch processing of parts is the preferred method for the inspection of multiple components provided the parts are small enough they can be processed simultaneously without touching one another.

2.4.8.6.7 Insufficient and Excessive Emulsification.

CAUTION

The part SHALL be completely reprocessed if, during or after the rinse step, it is suspected to be too short (insufficient emulsification) or too long (excessive emulsification) a dwell time has occurred.

Correction of dwell time cannot be achieved by immersing in penetrant or emulsifier. The part must be cleaned to remove all residual penetrant and reprocessed through the entire process. A good indicator of over-wash or over-removal of the surface penetrant is evidenced by a total lack of residue that may occur on all or specific areas of the part.

2.4.8.7 Removal of (Method “D”) Penetrants with Hydrophilic Remover.

2.4.8.7.1 Hydrophilic Remover Concentration.

CAUTION

Penetrant and remover are qualified as a system to be used together and SHALL NOT be interchanged.

Each penetrant manufacturer has its own formulation that varies in aggressiveness. The concentrations of hydrophilic remover (in water) can range from 5 to 35-percent. The concentrations used for qualification are identified in the Qualified Products List (QPL SAE AMS 2644) and should not be exceeded without approval from the responsible engineering authority. Caution SHALL be exercised when changes in suppliers are involved because the required concentration may change.

2.4.8.7.2 Using Hydrophilic Remover, (Method “D”) (Figure 2-16).

2.4.8.7.2.1 Hydrophilic Remover Pre-Rinse. The hydrophilic remover method differs from the lipophilic emulsifier in two ways: hydrophilic remover baths require mild agitation and pre-rinse is performed before parts are placed in the remover bath. The hydrophilic method requires spraying the part with clean water immediately following the penetrant dwell. The mechanical action of the water spray removes over 80-percent of the excess surface penetrant, leaving only a very thin uniform layer of surface penetrant on the part. The post penetrant dwell spray helps optimize the removal process by reducing the amount of remover consumed, and in immersion setups, minimizes contamination of remover due to penetrant carry-over. It also reduces remover contact time by approximately 50-percent compared to when no pre-rinse step is used. A pre-rinse step cannot be used in the lipophilic process, as the oil base emulsifier does not tolerate water. Slight agitation of the remover bath or movement of the part in the bath is regularly required to maintain fresh remover on the part surface while the part is submerged.

2.4.8.7.2.1.1 Pre-Rinse Procedure. The pre-rinse step SHALL be used since it improves the efficiency of the process and minimizes hazardous waste. Where possible, the spray nozzle SHALL be held a minimum of 12 inches from the part surface. The pre-rinse cycle SHALL be a coarse spray of clean water at a maximum pressure of 40 psi (275 kPa) for 30 to 120 seconds. The water temperature SHALL be between 50°F (10°C) and 100°F (38°C). The water pre-rinse SHALL be applied for the minimum amount of time required to achieve removal of the bulk surface penetrant. The objective is to reduce the amount of surface penetrant, while leaving only a thin layer remaining on the part. See Section 2.4.9 for proper rinse technique.

2.4.8.7.2.2 Different Hydrophilic Remover Application Techniques. Hydrophilic remover is typically applied by immersion, spraying or a combination of both. Brushing or swabbing shall not be used. Each technique offers certain advantages as well as disadvantages discussed in the following paragraphs.

2.4.8.7.2.2.1 Hydrophilic Remover Immersion.

NOTE

Excessive agitation as evidenced by foaming SHALL be avoided.

The primary advantage of the hydrophilic immersion technique compared to the spray technique is its effectiveness on hollow or complex geometry parts where the configuration interferes with the spray impinging on the part surface. In use, the part or parts are immersed in the remover tank while still wet from the pre-rinse. A slight agitation is necessary to bring fresh solution in contact with the surface. Agitation can be movement of the part through the solution, but is most usually produced by an air manifold in the bottom of the tank. Time of immersion depends on a large number of factors and will vary between 30-seconds up to 2-minutes and SHOULD be no more than necessary. The maximum time of 2-minutes is seldom required, except on very rough surfaces or when remover is depleted. Remover immersion time SHALL NOT exceed 2-minutes.

2.4.8.7.2.2.1.1 Remover Appearance. A freshly mixed remover bath is a transparent or clear, pink solution. During use, as penetrant is removed from the parts and retained, the bath becomes turbid or cloudy with distinct color change. As additional parts are processed and the penetrant tolerance point is approached, globules of penetrant will rise to the surface, and then slowly disperse back into the mixture. This effect is not usually noticed in an agitated bath, but is visible when the

agitation is shut off. When the penetrant tolerance point is reached, the penetrant will remain floating on the surface. A characteristic of the bath is that the excess penetrant does not spread across the surface, but collects at the sides. The remover will continue to function in this condition, but at a reduced rate. In addition to the longer removal time, another problem with using remover after the penetrant reaches its tolerance point, is the tendency of the floating penetrant to deposit on the part as it is withdrawn from the solution, resulting in an objectionable background. If the bath is to be used after the tolerance point is reached, the majority of the floating penetrant SHALL be removed. Do this by wiping the tank edges with absorbent newspaper, paper towel, or rags. To learn more about Process Control for penetrants, see [Paragraph 2.6](#).

2.4.8.7.2.2.1.2 Penetrant Tolerance. One of the disadvantages of the hydrophilic immersion technique is the remover's limited tolerance to penetrant contamination. As parts are processed, the amount of penetrant in the remover gradually increases. If the removal process is closely monitored, penetrant contamination will reach a point where a distinct performance change occurs. The amount of penetrant causing this performance change is called the "remover's penetrant tolerance point". The amount of penetrant tolerated is directly related to the concentration of the remover and sensitivity level of the penetrant. Typical tolerance levels for a remover concentration of 33-percent is 5 to 6-percent for a Sensitivity Level 3 penetrant, and 3 to 4-percent for a Sensitivity Level 2 penetrant.

2.4.8.7.2.2.2 Hydrophilic Remover Spray Technique.

2.4.8.7.2.2.2.1 Hydrophilic Remover Spray Mechanism. The modes of action are the same in both hydrophilic immersion and spray remover techniques; however, the relation between the chemical and mechanical action complicates the mechanism during the spray removal technique. As the spray water pressure is increased, the rate of removal also increases. A common misconception is the increased rate of removal is due solely to the greater mechanical action. The higher water pressure actually increases both mechanical and chemical action. As the water pressure increases, more solution contacts the surface per unit of time, thereby increasing the chemical action.

2.4.8.7.2.2.2.2 Hydrophilic Remover Spray Equipment. A practical and efficient way of handling the low remover concentrations is by continuously metering the remover directly into the stream of water. This can be done with an aspirator device that employs the water flow to create a vacuum (Bernoulli Effect), drawing up the concentrate directly from the container. The method is inexpensive and only requires a minimum of equipment and provides intermittent, on/off operation. A disadvantage of this system is the variation in concentration with water pressure. This requires the careful control of water pressure as well as the mixing ratio. The most commonly used system is the installation of a three-way valve on the water rinse or wash line. The aspirator is connected to one side, fresh or plain water to the second, while the third position is off. This allows the existing wash tank to be used for both spray removal and fresh water rinsing. For portable applications, a simple garden sprayer may also be used, provided the maximum 5-percent concentration is not exceeded.

2.4.8.7.2.2.2.3 Hydrophilic Remover Spray Technique. Hydrophilic remover can be applied by spraying the part with a mixture of water and remover. This method of application has several advantages: it does not require a separate tank; it works well on simple contoured parts; and it can be easily automated. The procedures, and equipment, and parameters are identical with those used in spray rinsing. The usual concentration range is 1 to 5-percent remover to water by volume. The concentration of remover SHALL NOT exceed 5-percent.

2.4.8.7.2.3 Hydrophilic Remover Final Water Post-Rinse. A clean water rinse SHALL be performed after the immersion or spray hydrophilic removal steps. The purpose is to remove any remover residues that could contaminate the developer or interfere with the development process. The rinse step is a water spray in the station or tank used for the pre-rinse. The process step is not critical and requires very few controls. The cycle SHALL be a clean water spray of up to a maximum of 120-seconds duration using a pressure of not greater than 40 psi (172 kPa) and the water temperature SHALL be between 50°F (10°C) to 100°F (38°C). Where possible, the spray nozzle SHALL be held a minimum of 12 inches from the part surface. Rinsing of fluorescent penetrants SHALL be accomplished under UV-A illumination. See Section 2.4.9 for proper rinse technique.

2.4.8.7.2.3.1 Hydrophilic Remover Touch-Up. One of the advantages of the hydrophilic technique is the ability to do touch-up removal on local areas after the initial application of the water rinse. Hydrophilic remover touch-up can be performed provided the combined remover dwell time of the first and second remover applications does not exceed 120- seconds (2-minutes). The hydrophilic remover touch-up, SHALL be applied using remover at or below the concentration of the initial remover step using either immersion or spray. If spray application is used, the remover concentration SHALL NOT exceed 5-percent. After touch-up, the part SHALL be fresh water rinsed. A check of the hydrophilic remover touch-up spray concentration SHALL be accomplished by one of the methods explained in [Paragraph 2.6.9.4](#). See [Paragraph 2.4.9](#) for proper rinse technique.

2.4.8.8 Removal of (Method "C") Penetrant With Solvent (Figure 2-15).

2.4.8.8.1 **General.** All oil-based penetrants are soluble in a large number of organic liquids; however, postemulsifiable penetrants are most frequently used in Method C processes. The majority of solvent removers are Class 2 (non-halogenated), and they can be further subdivided on the basis of their flash points or boiling points. For almost all solvent removers, removal of the excess surface penetrant is accomplished through dissolving and dilution. The exception to this is when an aqueous based detergent mixture is used as a solvent remover. Furthermore, when higher boiling point solvents are used care must be taken to control the amount of solvent applied to the surface. Excess solvent can strip penetrant from defects or dilute the penetrant in a defect with the result of producing dim, fuzzy indications.

2.4.8.8.2 **Factors Influencing Solvent Remover Selection.** The selection of a suitable solvent remover depends on a number of factors. The most significant factors are the evaporation rate (boiling point), flammability, and cost. Solvency is a factor but becomes significant only when the removal process allows excess solvent to remain on the surface of the part, thus diluting penetrant trapped in defects. For smooth surfaces, high boiling point solvents can be used with minimal concern since residual solvent can be easily wiped from the surface with a dry cloth. The higher boiling point solvents are also less flammable than lower boiling point solvents. For rougher surfaces, caution is required with the use of the higher boiling point materials; the lower boiling point solvents may be more appropriate since any residual solvent would evaporate before it could dilute the penetrant in a flaw. With the lower boiling point solvents, however, safety (flammability) may be a concern.

2.4.8.8.3 Solvent, (Method "C") Removal Procedure.

CAUTION

- The solvent cleaner SHALL NOT be applied directly onto the inspection area to remove excess penetrant.
- Only solvents appearing on QPL SAE AMS 2644 or technical grade Isopropyl Alcohol (TT-I-735, Grade A) SHALL be used for Method C removal of excess penetrant.
- All solvent residues must be removed from the inspection surface by a final dry cloth wipe before developer application.

The use of high sensitivity, postemulsifiable penetrant with the solvent removal method will produce indications from small, tight flaws, however, improper application procedures will seriously degrade the indications. The use of excess solvent will remove or dilute entrapped penetrant resulting in a failure to produce a visible indication. The following outlines the recommended practice for the Method C process:

- a. Following the penetrant dwell period, the surface SHALL be wiped with a clean, dry lint-free rag or paper towel to remove the major portion of surface penetrant. The proper procedure, which SHALL be followed, is to make only a single pass and then fold the rag or towel over to provide a fresh surface for each succeeding wipe.
- b. When the surface penetrant has been reduced to a minimum, any remaining residual penetrant is removed with a fresh lint-free rag or towel moistened with solvent. The amount of solvent applied to the rag or towel is critical. The cloth or towel SHALL only be lightly moistened with the application of a fine spray of solvent to the cloth. The cloth SHALL NOT be saturated either by pouring, immersion or excessive spraying.
- c. A UV-A lamp SHALL be used to examine the part surface during the intermediate and final wiping stages. If the surface stills shows penetrant, the cloth SHALL be folded to expose a clean surface, remoistened with solvent, and again wiped across the part.
- d. This procedure SHALL be repeated until the part surface shows little or no trace of penetrant.

2.4.9 **Water Washing/Rinsing Technique.** Water washing or spray rinsing is usually accomplished in a stationary rinse tank, which is provided with a hose, nozzle, drain, and in the case of fluorescent penetrant, UV-A illumination. Rinsing procedures used for removal of water-washable penetrant, Method "A", and postemulsifiable penetrant, Method "B" (after emulsification), and Method "D" (after remover application) are nearly identical. The difference is in controlling the rinse time. Rinse times for Method "A" penetrants are very critical as the entrapped water-washable penetrant can be removed from discontinuities if the time is not controlled. Entrapped postemulsifiable penetrants not diffused with emulsifier resist removal,

and rinse times are not as critical. The conditions and procedures described in the following paragraphs are applicable to both water-washable and postemulsifiable penetrants.

2.4.9.1 Factors Influencing Effectiveness of Wash/Rinse.

2.4.9.1.1 Size of Water Droplets. Removal of excess surface penetrant depends upon the mechanical force of the water impacting the part surface. The impact force consists of the droplet mass and velocity at impact. The two factors are related, and increasing either will produce a higher mechanical force. There are limits on both size and velocity; the latter is derived from the water pressure. If the droplet is small or if the pressure is too high, the result will be a fog or mist with little removal ability. On the other hand, a solid stream of water is not desirable either because it covers only a small area at one time or is actually one large continuous drop.

2.4.9.1.2 Water Pressure. Increased water pressure increases the speed of removal; however, excessive pressure can atomize the water into a fog that is useless for removal. Normal line pressure, approximately 10 to 40 psig, is acceptable and is generally used. Water pressures in excess of 40 psig SHALL NOT be used. If hydro-air nozzles are used, air pressure shall not exceed 25 psi.

2.4.9.1.3 Water Temperature. The temperature of the rinse water will affect the washability. Some penetrant-emulsifier combinations may form a gel with water temperatures of 50°F (10°C) or less. This gel can be removed but requires longer wash times. Other penetrant emulsifier combinations have reduced removability at elevated temperatures, above 110°F (43°C). The effect of temperature on washability depends upon the penetrant formulation, which varies between suppliers. Penetrant-emulsifier combinations meeting specification requirements are washable in the temperature range of 50°F (10°C) to 100°F (38°C). Therefore, the rinse water temperature SHALL be maintained between 50°F (10°C) to 100°F (38°C).

2.4.9.1.4 Spray Angle.

CAUTION

Water nozzles capable of producing spray patterns such as solid streams or a fine mist SHALL NOT be used. Rinsing dye penetrant from the surfaces of parts SHALL be accomplished with a fan-shaped, coarse spray.

The angle of spray may be varied over a wide range with only slight effects on the removal time. When the angle is close to perpendicular (80 to 90 degrees), the droplets will rebound into the oncoming water, diverting the fresh droplets, which reduces the scrubbing action. The scrubbing action is also reduced when the spray is close to parallel with the part surface (10 to 20 degrees), since there is little energy transfer at the point of impact. Generally, an angle of 45 to 70 degrees is most effective.

2.4.9.1.4.1 Recommended Spray Rinse Procedure. Washing is best accomplished with a fan shaped, coarse spray. Where possible, the spray nozzle SHALL be held a minimum of 12 inches from the part surface. The water temperature SHALL be in the range of 50°F (10°C) to 100°F (38°C), and line water pressure SHALL NOT exceed 40 psig. The wash time will depend upon the surface roughness of the part. Water-washable penetrant can easily be over-washed and wash time SHALL be closely controlled. Washing of fluorescent penetrant SHALL be performed under UV-A black light illumination in a semi-darkened area. The washing SHALL be stopped when a low background level is reached. If small defects must be detected in parts with rough surfaces, some residual background may be necessary. The total rinse time SHALL NOT exceed 120-seconds.

2.4.10 Drying. After removal of excess surface penetrant, the part SHALL be dried prior to applying nonaqueous or dry developer. When aqueous developers are used, part drying before developer application is not required. Drying can be accomplished in a number of ways:

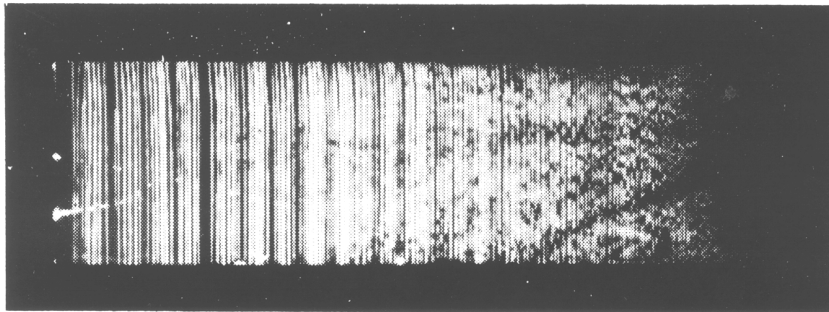
- Allow the parts to set at room temperature in still air. The length of time required for this method depends upon temperature and humidity of the air and is usually too long to be used for drying wet developer.
- Warm air blowers are often used on large parts that cannot be oven dried. This method may not uniformly dry wet developers.

- The most frequently used method of drying parts is with a recirculating hot air oven. It provides a rapid means of properly drying parts and wet developer, is adaptable to production, and permits control of the temperature.

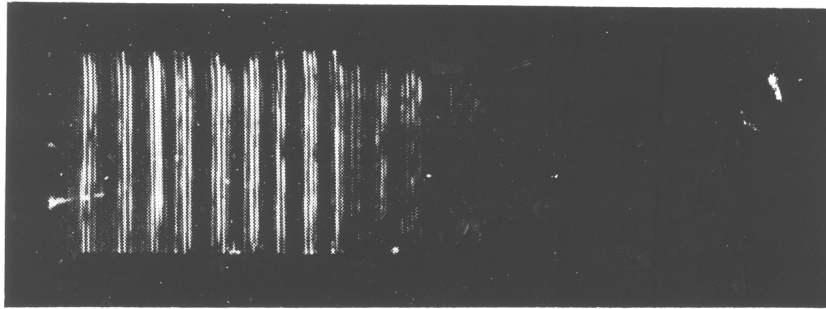
2.4.10.1 Time and Temperature Effects on Drying.

NOTE

- Depots with automated and semi-automated penetrant inspection systems may exceed the 140°F (60°C) drying oven temperature while performing inspections with these systems. The part temperature SHALL NOT exceed 140°F (60°C). All parts remaining at 140°F (60°C) for longer than ten minutes or exceeding 140°F (60°C) SHALL be reprocessed (cleaned and reinspected).
- When drying test parts in a recirculating oven, both time of exposure and dryer temperature SHALL be carefully monitored. The smallest quantity of penetrant entrapped in discontinuities can be subject to dye degradation and/or large evaporation losses. Fluorescent dyes experience heat fade or permanent loss of fluorescence at elevated temperatures. Heat fading of the penetrant starts at about 140°F (60°C) and increases rapidly with increased temperatures and time. Evaporation loss can decrease the small amount of penetrant entrapped in a discontinuity to such a low level it will not contact the developer on the surface and an indication will not form. The effects of drying temperature and time are more severe when a dry developer is used. Aqueous or wet developers are applied before application of heat in a drying oven and may retain contact with the penetrant during the drying cycle. The base vehicle (water) of the developer tends to mix with the penetrant in the defect. The evaporating action of the base vehicle helps to draw the penetrant from the defect to form the indication. For comparisons of proper versus excessive drying for Sensitivity Level 3 penetrant prior to applying dry developer ([Figure 2-24](#)). Proper drying was performed at 120°F (49°C) for five minutes. Excessive drying was at 150°F (66°C) for ten minutes. The fine indications are the first to disappear.



PROPER DRYING



OVER DRYING

Figure 2-24. Effects of Proper vs. Excessive Drying

2.4.10.2 Procedure for Determining Pre-Developer Drying Parameters.

CAUTION

Parts SHALL be separated with an air space between them. If the part temperature reaches and remains at 140°F (60°C) for over ten minutes, the inspection sensitivity can be reduced. As a guideline remove the parts before they become too hot to handle with bare hands. This is a temperature of about 120-125°F (49-52°C).

It is easy to monitor and control oven temperature, but almost impossible to monitor test part temperatures. Another complicating factor is the rate at which the part undergoing the test, heats. Thin sections will reach oven temperature and dry before thick sections become warm. The recommended procedure is to set the oven temperature between 120 and 140°F (49 -60°C), and check the part every 5-10 minutes. Remove the part as soon as it is dry.

2.4.11 Application of Developers.

2.4.11.1 (Form a) - Dry Developer.

2.4.11.1.1 Description.

CAUTION

Dry developers SHALL NOT be used with visible-dye penetrants since they do not provide adequate contrast.

Dry developer is characterized by their fluffy nature and low bulk density, i.e., one pound of dry developer occupies 2 or 3 times the volume required for wet developer powders in the dry form. Dry developer is loosely held on the part surface by adhesion and the coating layer is very thin and uniform. In fact, dry developers leave very little visible trace, but their presence becomes readily obvious when a finger or rag is wiped across the surface. Dry developers can be used with any method of fluorescent penetrant, but not with visible-dye penetrant.

2.4.11.1.2 Advantages of (Form a) - Dry Developer.

- Does not require a liquid bath.
- Easier to transport than liquid bath.

2.4.11.1.3 Disadvantages of (Form a) - Dry Developer.

- Air cleaners, facemasks, or respirators may be required.
- Part must be completely dry prior to application.

2.4.11.1.4 Using (Form a) - Dry Developer.

2.4.11.1.4.1 Preparation of (Form a) - Dry Developer. There is no preparation short of having a container that will help to keep moisture out of the developer.

2.4.11.1.4.2 Application of (Form a) - Dry Developer.

WARNING

Dry developer particles are not toxic materials; however, like any solid foreign matter; they SHALL NOT be inhaled. Air cleaners, facemasks, or respirators may be required. The Installation Bioenvironmental Engineer SHALL be consulted if the process generates airborne particles.

NOTE

Dry developers SHALL NOT be applied to a part until the surface and any discontinuities are thoroughly free of moisture. The presence of even a little moisture will interfere with the developer action and small flaws may be missed.

Dry developers can be applied in a number of ways:

- Blowing the powder with a bulb type blower.
- Immersing the part in a container of dry particle powder.
- Pouring the powder over the parts.
- Using a dust or fog chamber where the particles are blown into an air suspension.

- Spraying with an electrostatic system or a low-pressure flock gun.

2.4.11.1.4.2.1 After application, the excess developer SHALL be shaken off or removed with a hand air bulb or squeeze blower. The developer particles are not loosely held, but care SHALL be taken to not remove them during handling. Wiping, brushing, or compressed air in excess of 5 psig SHALL NOT be used. Care SHALL be taken to prevent contamination of the dry developer. The two most frequent contaminants are water (or moisture) and penetrant. Water in dry developer comes from parts that have not been completely dried or from careless splashing during the wash step. Water or moisture contamination will cause the dry developer to form lumps or to cake, thus reducing its effectiveness. Penetrant contamination occurs when particles of penetrant soaked developer fall from poorly washed parts or heavy indications. Penetrant contamination will cause false indications either on the part being processed or on subsequent parts.

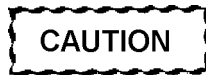
2.4.11.2 (Form b) - Water-Soluble (Wet Aqueous) Developer.

2.4.11.2.1 Description. Water-soluble developers are developer particles dissolved in a water solution. Water-soluble developers contain wetting agents, corrosion inhibitors, and biocides. They differ from wet suspended developer since the particles dissolve in water to form a clear, lightly tinted solution. During the drying process, the developer particles crystallize out of solution as the water evaporates. The resulting coating is thick, bright white and readily visible. The dry layer is thicker than wet suspended developer coating, and much thicker than a dry developer coating.

2.4.11.2.2 Advantages of (Form b) - Water-Soluble Developers.

- The primary advantage of water-soluble compared to water-suspended developer is the elimination of the need for agitation to keep the particles in suspension.
- The coating does not produce streaks or runs that often occur with wet suspended developers.
- The developer particles, being soluble in water, are very easy to remove during post-cleaning.

2.4.11.2.3 Disadvantages of (Form b) - Water-Soluble Developers.



Water-soluble developers SHALL NOT be used on parts processed with water-washable penetrant or visible-dye penetrants.

NOTE

Water-soluble developers are subject to bacterial growth. The susceptibility is dependent on the geographical area and the type of local water. The first indication can be a foul odor or visible growth.

- Water-soluble developers contain wetting agents that can act as penetrant removers and SHALL be used very carefully. This removal action is accelerated with water washable penetrants and is the reason water-soluble developers SHALL NOT be used with water washable penetrants.
- Even though a thick, white coating is produced, water-soluble developers do not function well with visible-dye penetrants.
- Like the wet suspendible developers, the biocides in water-soluble developers only delay growth. The water-soluble developers SHALL be discarded when bacterial growth is noticed and the tank or container SHALL be completely disinfected prior to mixing a new solution.

2.4.11.2.4 Using (Form b) - Water-Soluble Developer.

2.4.11.2.4.1 Preparation of (Form b) - Water-Soluble Developer. Water-soluble developers are supplied as dry-powders and SHALL be completely dissolved in water before use. The proportions of dry-powder to water depend upon the type of developer and the manufacturer. The manufacturer's recommendations on concentration SHALL be followed. In making up the bath, the dry-powder SHALL be stirred into the water until it has completely dissolved. Since the developer par-

tics are dissolved in the solution, agitation is not required after the developer has been initially mixed with water. Specific procedures to accomplish preparation of water-soluble developers is published in TO 33B-1-2, WP 102 00.

2.4.11.2.4.2 Application of (Form b) - Water-Soluble Developer.

CAUTION

Water-soluble developers SHALL NOT be used on parts processed with water-washable, Method A, fluorescent penetrants or any visible-dye penetrants.

NOTE

Water-soluble developer in open immersion tanks is subject to evaporation. As the water evaporates, the developer concentration increases. A solution concentration level SHALL be established and maintained by the addition of water or dry-powder. For process checks and methods for measuring solution concentration ([Paragraph 2.6](#)).

The inspector may apply developer with spraying, flowing, or immersion techniques. If the immersion process is used, the part SHALL not remain in the solution any longer than required to provide complete coverage. The developer may be applied to parts while they are still wet from the water wash after penetrant removal. Care SHALL be exercised to prevent entrapment of soluble developer in the part cavities or concave surfaces (pooling). The developer should wet the part surface with no water break areas after application. After the developer is applied, the parts SHALL be oven dried, since room temperature evaporation is too slow. The developing action, and thus the developing time, does not start until the developer is dry.

2.4.11.3 (Form c) - Water-Suspended (Wet Aqueous) Developer.

2.4.11.3.1 Description.

NOTE

Developing action in wet suspended developers will not start until all the absorbed and adsorbed water has been driven off. Developer dwell time SHALL NOT begin until the part is completely free of moisture.

Water-suspended developers consist of inert particles in a water suspension. The developers are supplied as either concentrated liquid or as a bulk, dry-powder that must be mixed with water prior to use. In addition they contain chemical dispersing agents to reduce the tendency of the developer particles to stick together or form clumps. Wetting agents are added to provide complete and thorough coverage of the parts. Corrosion inhibitors are added to protect the part from corrosive attack. Finally, biocides are added to provide a reasonable tank life by delaying bacterial growth. When applied, water-suspended developers evaporate very slowly at room temperature and require a hot air oven for proper drying.

2.4.11.3.2 Advantages of (Form c) - Water-Suspended Developer.

- The particles are insoluble in water and when dry, are highly adsorptive and absorptive.
- It can be used with Method A - Water-Washable Penetrants.

2.4.11.3.3 Disadvantages of (Form c) - Water-Suspended Developer.

- Agitation is required to keep the particles in suspension.
- Water-suspended developers may produce streaks or runs.

2.4.11.3.4 Using (Form c) - Water-Suspended Developer.

2.4.11.3.4.1 Preparation of (Form c) - Water-Suspended Developer. Use of wet suspended (Form c) developer requires the use of a drying oven therefore it is always used in stationary penetrant systems. Wet developer concentrates SHALL be mixed with water in the proportions recommended by the manufacturer. The concentrations vary between types and manufacturers. The measured quantity of powder or liquid concentrate is added to the water, while stirring constantly until a smoothly mixed suspension is obtained. A newly mixed batch of suspended developer SHALL stand for 4 or 5-hours be-

fore use to allow the developer particles to wet. Specific procedures to accomplish preparation of water-suspended developers is published in TO 33B-1-2, WP 102 00.

2.4.11.3.4.2 Application of (Form c) - Water-Suspended Developer.

CAUTION

- Water-suspended developers must either be constantly agitated to keep the particles from settling out of the suspension or the suspension SHALL be thoroughly agitated prior to use.
- The drain time for water-suspended developers SHALL NOT exceed 30-seconds.

Water-suspended developers may be applied by spraying, flowing or immersion. Wet developer, since it has a water base, can be applied to parts still wet from penetrant removal. When the part has been thoroughly covered with the developer solution, it SHALL be immediately removed from the solution and allowed to drain for a short time. Care must be exercised to prevent entrapment of soluble developer in the part cavities or concave surfaces (pooling). The developer SHALL wet the part surface with no water break areas after application. After the developer is applied, the parts SHALL be oven dried, since room temperature evaporation is too slow.

NOTE

The developing action, and thus the development time does not start until the developer is dry.

2.4.11.4 (Form d and Form e) - Nonaqueous Solvent- Based Developer.

2.4.11.4.1 Description. Nonaqueous solvent- based developers are composed of particles of developer suspended in a mixture of volatile solvents. These developers are typically packaged in ready-to-use aerosol cans. The penetrant materials specification QPL SAE AMS 2644 classifies nonaqueous solvent-based developers into two categories; (Form d), formulated for Type I fluorescent penetrant systems and (Form e), formulated for Type II visible penetrant systems. Many nonaqueous developers are formulated to perform as both (Form d and Form e) developers. The suspending solvents of these developers are carefully selected for their compatibility with penetrants. Solvent developers also contain surfactants and dispersants whose functions are to coat the particles and reduce their tendency to clump or collect together. Solvent developers are the most sensitive forms of developers due to the solvent action contributing to the adsorption and absorption mechanisms. In many cases where tight, small flaws occur, the dry and aqueous developers do not contact the entrapped penetrant. This results in the failure of the developer to create the necessary capillary and surface tension forces that serve to pull the penetrant from the flaw. The nonaqueous developer solvents enter the flaw and dissolve into the penetrant. This action increases the volume and reduces the viscosity of the penetrant. Developer manufacturers must carefully select and compound the solvent mixture. Either excessive or inadequate volatility or solubility will adversely affect the performance of the developing action. High volatility reduces the time for the developer to function before it evaporates, while low volatility increases the drying time. Low solubility reduces the penetrant dissolving action, so the extraction of the penetrant from the flaw will not be enhanced.

2.4.11.4.2 Advantages of (Form d and Form e) - Nonaqueous Developers.

- Nonaqueous solvent-based developers are packaged in portable aerosol containers.
- Nonaqueous solvent-based developers are volatile and fast drying in air, thus eliminating the need for a drying oven.
- Nonaqueous solvent-based developers are sealed in their containers and are not recovered after their initial use, which eliminates any degradation by contamination.
- When proper techniques are used, nonaqueous-solvent-based developers provide a smooth, even layer of developer whose thickness can be controlled by the operator.
- Nonaqueous solvent-based developers can be used with both fluorescent and visible-dye penetrants.
- Nonaqueous solvent-based developers are capable of producing the highest level of sensitivity of any of the developer forms due to their solvent action.

2.4.11.4.3 Disadvantages of (Form d and Form e) - Nonaqueous Developers.

WARNING

Nonaqueous solvent-based developers contain solvents that can be flammable, and when used in confined locations, present a health hazard. Caution SHALL be exercised to prevent ignition and to avoid inhalation of the vapors.

- The developer particles are suspended in the solvent and tend to rapidly settle out. Agitation of the container prior to and during application is required.
- The portable aerosol containers have a small spray coverage that makes coating of a large surface very time consuming. The aerosols are best limited to small, local areas.
- Aerosol cans exhibit a gradual loss of pressure over a period of time and occasionally there are leaks due to improper sealing. When the pressure is lost, the can and its remaining contents must be properly discarded.
- If the nozzle is not free of dried developer particles, spray patterns can be very erratic. It is necessary to clean the nozzle after every use by inverting the can and pressing the spray nozzle until only propellant escapes.

2.4.11.4.4 Using (Form d and Form e) - Nonaqueous Developer.

2.4.11.4.4.1 Preparation of (Form d and Form e) - Nonaqueous Developer.

CAUTION

The presence of any moisture will interfere with the developer action and small flaws may be missed. Like dry-powder developers, solvent developers SHALL NOT be applied to a part until the surface and any discontinuities are thoroughly free of moisture or solvent residues.

Since these developers are self-contained in a pressurized spray can, the only preparation required is shaking the can in order to thoroughly mix the developer, carrier solvent, and propellant.

2.4.11.4.5 Application of (Form d and Form e) - Nonaqueous Solvent-Based Developers.

NOTE

Excessive thickness of developer SHALL NOT occur. Parts that have received excessive developer SHALL be completely reprocessed. Liquid flow on the part surface SHALL be avoided.

Nonaqueous solvent-based developers are always applied by spraying. Proper spraying produces a thin, uniform layer very sensitive in producing indications. Dipping, pouring, or brushing is not suitable for applying solvent-based developer. Dipping and pouring increases the time the solvent is dissolving and diluting the entrapped penetrant so much of it ends up in the un-evaporated liquid developer layer. During the drain, the penetrant will flow from the flaw site, and any indications that do form will be weak and badly distorted. Application of solvent developer by brushing will also leave streaks and distort and smear flaw indications into unrecognizable forms.

- Nonaqueous solvent-based developer SHALL be applied only as a fine spray or mist. Spraying of nonaqueous developer is most often done with pressurized, aerosol containers. There are a few production lines that use pressure pots and spray guns. Electrostatic spraying is possible, but is seldom used due to the poor throwing power of the spray.
- Prior to spray application, the container SHALL be agitated. Nonaqueous solvent-based developer is usually a suspension and the particles settle out in a matter of minutes. The spray can or gun SHALL be held far enough from the surface to produce a light, moist film. The recommended technique is to apply a very thin, dry layer and build up the thickness with several passes rather than applying a single, wet pass.

- The optimum coating thickness depends on the penetrant system type (i.e., visible or fluorescent dye) and must be judged from its appearance, based upon training and prior experience. When using Type I penetrant systems, the luster or surface texture of the part surface SHALL NOT be completely hidden. If the metallic luster cannot be seen, the developer layer is too thick, and small indications may be masked or too widely spread or blurred. Developer coatings that are too thin may not extract a sufficient amount of entrapped penetrant to form an indication. Also, too thin of a coat does not allow the penetrant to spread and magnify the indication. For Type II penetrant systems, a slightly thicker coating is required to provide a solid white background to contrast with the visible indication. The metallic luster will still be visible under bright white light in most cases.
- Observe the comparison of a cracked aluminum panel with optimum developer thickness for a Type II (visible) penetrant system, to one where an excessive developer layer has been applied is reflected in [Figure 2-25](#).

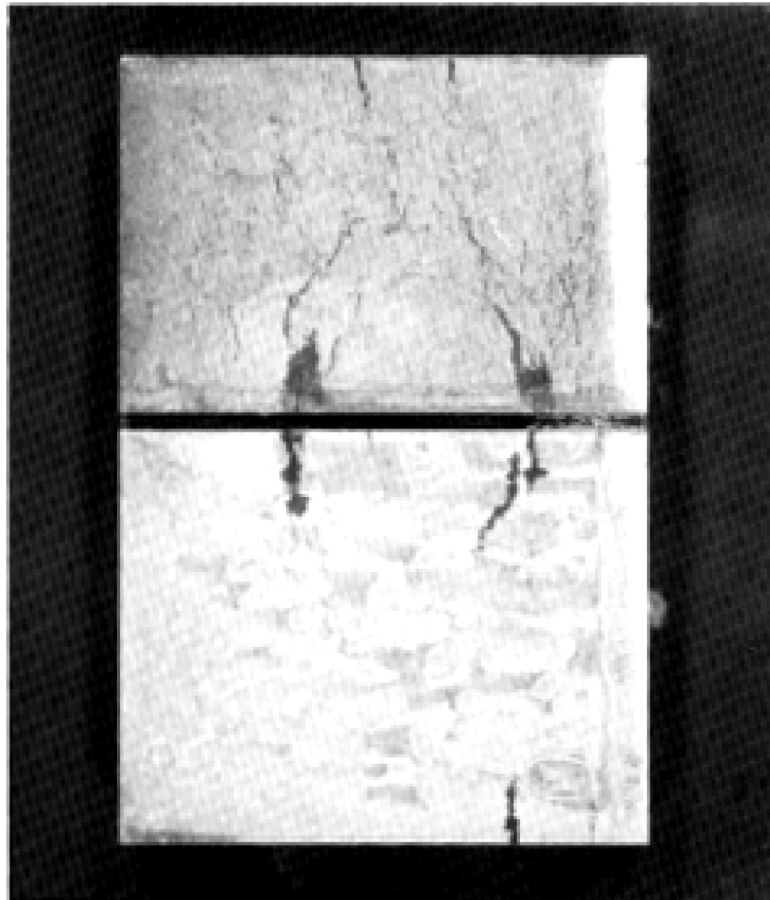


Figure 2-25. Cracked, Aluminum Panel Comparing Results of an Optimum Thickness Layer of Developer (Top) to an Excessive Thickness Layer of Developer (Bottom)

2.4.11.5 Developer Dwell (Development Time).

NOTE

- The developer dwell time SHALL NOT start until part is completely free of moisture or solvent. The dwell time for form a (dry developers) begins immediately after developer application. The dwell time for form b, c, d and e developers begins immediately after the developer is completely dry.
- The maximum developer dwell time SHALL NOT be exceeded.
- The dwell times specified are based on small discontinuities.
- Extraction of the penetrant entrapped in a flaw is a function of time and volume of available penetrant. Sufficient time SHALL be allowed for the developer to draw the entrapped penetrant from the flaw and spread it on the part surface to form the indication. The length of developing time varies widely with a number of influencing factors.
- Indications from small discontinuities may not form if the minimum dwell time is not met or may exhibit a very diffuse indication if the maximum dwell time is exceeded. In either case, these discontinuities may be missed. The minimum and maximum developer dwell time SHALL be followed: [Table 2-4](#).
- Medium or large discontinuities, which develop faster, will be blurred at the maximum dwell times; however, medium or large discontinuities contain enough penetrant to form an observable indication even though it is blurred. The lateral diffusion of penetrant over a period of time can be so great that the indications may become indistinct, even for medium and large discontinuities.
- To increase penetrant system capability, parts should be viewed periodically during developing; however, the minimum dwell time SHALL be met. Developer action starts when the developer is completely dry and continues until all of the available penetrant is extracted. An indication will gradually form, reach a maximum resolution point (bright and sharp), and then begin to degrade.

2.4.11.5.1 Minimum and Maximum Developer Dwell Times. The minimum and maximum developer dwell times SHOULD be specified in the technical directives or part specific procedures mandating the inspection. Both the minimum and maximum developer dwell times that SHALL be used in the absence of specific technical directives or procedures are listed in [Table 2-4](#). These dwell times are based on the developer form, the ambient temperature, and the expected flaw condition.

Table 2-4. Developer Dwell Times

Temperature 40° - 60°F		
<u>Nonaqueous Developer</u>	<u>Minimum</u>	<u>Maximum</u>
Service Damage/Fatigue Cracks	20 minutes	60 minutes
Stress-Corrosion Crack	60 minutes	120 minutes
<u>Aqueous Developer</u>		
Service Damage/Fatigue Cracks	30 minutes	120 minutes
Stress-Corrosion Crack	60 minutes	120 minutes
<u>Dry Developer</u>		
Service Damage/Fatigue Cracks	30 minutes	240 minutes
Stress-Corrosion Crack	60 minutes	240 minutes
Temperature 60° - 125°F		
<u>Nonaqueous Developer</u>	<u>Minimum</u>	<u>Maximum</u>
Service Damage/Fatigue Cracks	10 minutes	30 minutes
Stress-Corrosion Crack	30 minutes	60 minutes

Table 2-4. Developer Dwell Times - Continued

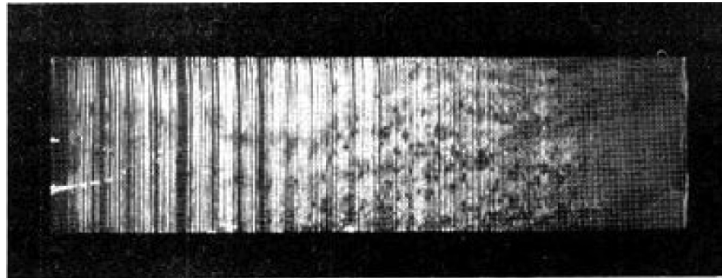
<u>Aqueous Developer</u>		
Service Damage/Fatigue Cracks	10 minutes	60 minutes
Stress-Corrosion Crack	30 minutes	120 minutes
<u>Dry Developer</u>		
Service Damage/Fatigue Cracks	10 minutes	120 minutes
Stress-Corrosion Crack	30 minutes	240 minutes

2.4.11.5.2 To increase penetrant system capability, parts should be viewed periodically during developing. Over-development (i.e., too long a development time), is possible and SHALL be avoided. Developer action starts when the developer is completely dry and continues until all of the available penetrant is extracted. An indication will gradually form, reach a maximum resolution point (bright and sharp), and then begin to degrade. The lateral diffusion of penetrant over a period of time can be so great the indication becomes indistinct. Medium size or large discontinuities will appear as a smear or blob of penetrant. Small indications are especially critical, since the small amount of penetrant may not be observed when it diffuses.

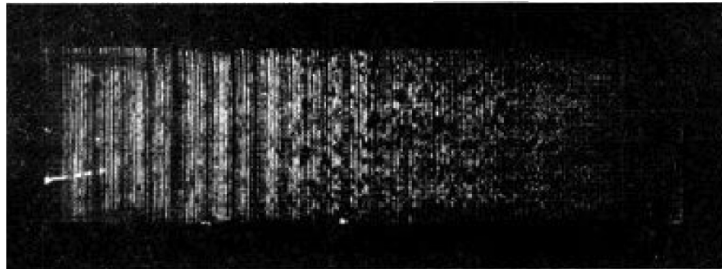
2.4.11.6 **Comparison of Developers.** The relative sensitivities of penetrant inspection with various forms of developer are influenced by a number of factors. The method of applying the developer produces a range of sensitivities for each of the developer forms. Some of the common forms of developer, plus the application method, arranged in order of decreasing sensitivity are listed ([Table 2-5](#)). This is the sensitivity order most generally accepted. It is recognized that solvent-suspended developers applied by spraying produce a highly sensitive penetrant system. Industry agreement on the developer sensitivity order ends at this point. The type of test sample, type of flaw, flaw size and shape, type of penetrant, method of removal, and drying procedures will affect the sensitivity of the penetrant system. The number of variables involved has resulted in conflicting reports on the relative performance of dry versus water-based (suspended and soluble) developers. When properly applied, it is agreed the water-based developers form a coating with a finer matrix of developer particles that are in more intimate contact with the part surface when compared to dry developers. The opposing argument is that an uneven coating of water-based developers can mask indications. There is agreement that water-soluble developers SHALL NOT be used on water washable penetrant. Photographs of a single cracked-chrome plated panel, that has been processed with four forms of developer using application methods available to base level NDI laboratories are contained in [Figure 2-26](#).

Table 2-5. Developer Forms and Application Methods in a Decreasing Sensitivity Order

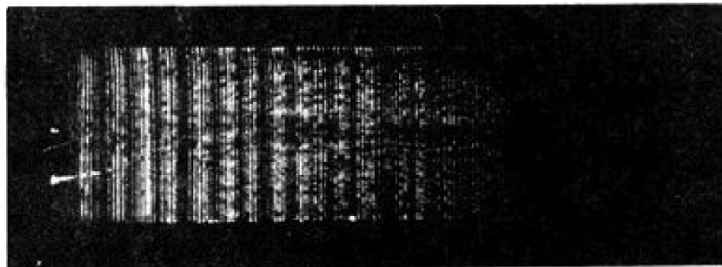
Developer Form	Application Method	Sensitivity
Nonaqueous-Wet (Solvent Suspended)	Spray	Highly Sensitive
Water-Soluble	Spray	Highly Sensitive
Water- Suspended	Spray	Highly Sensitive
Water-Suspended	Immersion	Highly Sensitive
Water-Soluble	Immersion	Highly Sensitive
Dry-Powder	Electrostatic Spray	Decreasing Sensitivity
Dry-Powder	Fluidized Bed	Decreasing Sensitivity
Dry-Powder	Air Agitated Dust Cloud	Decreasing Sensitivity
Dry-Powder	Dip and Pour	Least Sensitive



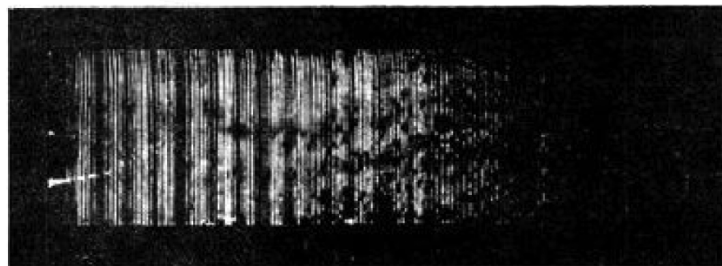
a. DRY DEVELOPER, DRY



b. WATER SOLUBLE DEVELOPER, IMMERSION



c. WATER SUSPENDED DEVELOPER, IMMERSION



d. DRY DEVELOPER, IMMERSION

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Figure 2-26. Comparison of Four Forms of Developer on a Cracked Chrome Panel

2.4.11.7 Self-Development.

CAUTION

Self-development SHALL NOT be used in aircraft and engine maintenance inspection where service-induced flaws must be detected. Self-development SHALL NOT be used for aircraft and engine component inspection unless specifically approved by the responsible NDI engineering authority.

Self-development is the formation of an indication without the application of a developer material. All penetrants are capable of some degree of self-development since they will exude from a discontinuity and spread over the surface. The critical factors are the size and volume of the discontinuities that must be detected. A relatively large volume of entrapped penetrant is required, and self-development is not reliable in detecting small, tight flaws.

2.4.12 Post-Cleaning After Penetrant Inspection.

2.4.12.1 Effects of Inspection Residues on Subsequent Service.

WARNING

Parts that will contact liquid oxygen SHALL be given special attention. Traces of oil can cause an explosion when contacted by liquid oxygen.

Penetrant inspection residues can have several adverse effects on subsequent processing and service. Developer and penetrant residues left on the test part, have detrimental effects on the application of surface finishes such as painting, plating, and anodizing. Penetrant residues left in the discontinuities can seriously affect the weld quality if not removed prior to repair welding. Developer residues can interfere with the functioning of the part if they involve a moving or wear surface. In addition, developer materials can absorb and retain moisture resulting in corrosion of the part.

2.4.12.2 Removal of Inspection Residues. Chemicals used in the penetrant inspection process could present problems to the inspection and/or the part after the inspection. Care SHALL be taken to ensure the part is free of all residues, which could present problems to the inspection process or the parts usability.

2.4.12.2.1 Developer Residue Removal. Developers are the last material applied in the penetrant process and may be one of several forms. The form of developer applied (dry-powder, nonaqueous, water suspendible, or water-soluble) greatly influences the method and difficulties of removal. One point common to most developers is the increase in adherence with time on the part. The longer a developer remains on a part, the more difficult it is to remove. Removal of the developer coating SHALL be accomplished as soon as possible after completing the penetrant inspection.

2.4.12.2.1.1 Removal of Dry-Powder Developer. Dry-powder developer adheres to all areas where applied. Some dry-powder may lodge in recessed areas, faying surface joints, or crevices. Dry-powder particles can be removed with a water-soluble detergent wash followed by a water rinse. Dry-developer particles adhering to penetrant bleed-out SHALL be removed during the "Removal of Penetrant Residues" described below (see [Paragraph 2.4.12.2.2](#)).

2.4.12.2.1.2 Removal of Nonaqueous Developer.

NOTE

To avoid spreading developer particles over a larger area, aerosol solvent SHALL NOT be directly sprayed on the developer without first hand-wiping.

Aerosol solvent spraying may be used as a final step to remove residual or trace amounts of developer when it is not practical to use water. Nonaqueous developer is usually applied by spraying from an aerosol can. The majority of applications involve a relatively small area. This makes it advantageous to initially remove the developer by hand-wiping the surface with a dry cloth or paper towel. The remaining traces of developer can then be removed with water or alcohol moistened rag or paper towel. The inspected area may contain threads, crevices, and surface recesses where wiping will not remove all of the devel-

oper particles. These areas should be pressure sprayed with a water and detergent solution after the initial wipe. Solvent spraying is not particularly effective, as the developer is usually insoluble. A vapor degreaser SHALL NOT be used because the elevated temperature bakes or hardens the developer coating.

2.4.12.2.1.3 Removal of Water-Soluble Developer. Water-soluble developer is the easiest form to remove since the developer coating readily re-dissolves in water. Immersion or pressure spraying with water SHALL be performed to remove water-soluble developer.

2.4.12.2.1.4 Removal of Water Suspendible Developer. The removal characteristics of water suspendible developer are very similar to non-aqueous developer. The best method of removal is immersion and pressure spraying with a hot detergent solution. It can also be removed with a plain water spray and hand scrubbing with a fiber bristle brush.

2.4.12.2.2 Removal of Penetrant Residues. Removal of residual penetrant is almost always required. This step usually follows the developer removal. The amount of residual penetrant is small, consisting of penetrant retained in discontinuities, crevices, and part surface irregularities. Penetrant residues generally can be removed with liquid solvents and detergent or alkaline cleaning.

2.4.13 Protection of Parts Following Penetrant Inspection. The penetrant inspection process and subsequent removal of inspection residues leave the parts with a chemically clean surface. These surfaces, especially ferrous materials, are highly reactive and may corrode from the moisture in air. Such parts should receive a corrosion protection treatment as soon after the inspection and subsequent cleaning as required.

SECTION V INTERPRETATION OF LIQUID PENETRANT INSPECTION

2.5 INTERPRETATION OF INDICATIONS.

2.5.1 General. Successful detection of flaws by the penetrant inspection method depends upon many factors, chiefly, among which are the selection of the appropriate materials and process, the proper application of the chosen process, the quality of lighting during the examination and the ability of a technician to detect flaw indications. Interpretation is the process of determining whether an indication is relevant, non-relevant, or false. Evaluation involves assessing a relevant indication to determine its cause and type and reporting its category, location, and approximate size.

2.5.2 Importance of Understanding the Interpretation Process. The purpose of the penetrant inspection process is to detect flaws that will affect the integrity of a part. Many of these flaws may be very small. All of the penetrant materials, procedures, and process controls are oriented to producing valid indications from surface discontinuities. The inspection or examination step is one of the most important and frequently the least controlled of all the process steps. Marginally controlled inspection or examination conditions will degrade the entire penetrant process. Maximum benefits can only be obtained when all aspects of the process (e.g., personnel training and qualification, lighting, and inspection environment) receive equal management emphasis.

2.5.2.1 The apparent simplicity of the penetrant process is misleading. While the penetrant process is relatively straightforward, a successful inspection depends upon following very carefully prepared step-by-step procedures, from initial part cleaning to part examination and indication interpretation. An improper or marginal process step may not be recognizable in the inspection booth. As a result, a serious flaw may not be indicated. Many times, the first indicator of process degradation occurs during an individual process step. For example, an excessive emulsification time or an improper water-spray pattern can be identified at the time of the respective process steps, but the consequent removal of penetrant from a defect would go unnoticed.

2.5.3 Personnel Requirements.

CAUTION

All personnel performing any of the penetrant process steps SHALL be qualified in accordance with [Paragraph 1.2](#).

Personnel, responsible for processing of part through one or more of the penetrant process steps, but do not inspect or interpret indications, SHALL have a basic knowledge of the process theory, practical aspects, and equipment operation. They SHALL be aware of the process control requirements and of the effects of improper procedures or degraded materials on the formation of indications.

2.5.3.1 Personnel, responsible for processing of part through one or more of the penetrant process steps, and for interpreting and evaluating penetrant indications SHALL have a detailed knowledge of the theory, practical aspects, and application procedures for the major penetrant processes. They SHALL be capable of performing all of the process steps, performing materials, and process control tests, and providing technical guidance to operators and trainees. In addition, they SHALL have knowledge of the potential types of discontinuities peculiar to the part being inspected, be familiar with the appearance of penetrant indications of those discontinuities, and have experience in interpretation and evaluation of indications. It is essential for an inspector to gain experience by working with other individuals who possess the required skill before being assigned interpretation responsibilities.

2.5.4 Lighting.

2.5.4.1 Ultraviolet (UV-) Light Illumination.

2.5.4.1.1 Characteristics. Ultraviolet (UV-) light is electromagnetic radiation with a wavelength ranging between X-rays and visible light, but is not visible to the human eye. The ultraviolet range is usually divided into three bands:

2.5.4.1.1.1 UV-A - Soft ultraviolet or long wavelength (320 to 400 nm), commonly called "UV-A" is just below visible wavelength range of 400 to 760 nm. The electromagnetic spectrum showing the relatively small band of ultraviolet radiation used in fluorescent penetrant inspection ([Figure 2-27](#)). UV-A is near the violet end of the visible light range (near 400 nm).

2.5.4.1.1.2 UV-B - Medium wavelength (280 to 320 nm), used for examining minerals and in suntan lamps.

2.5.4.1.1.3 UV-C - Hard ultraviolet or short wavelength (180 to 280 nm), used in germicidal or sterilizing lamps.

WAVELENGTH MEASUREMENT UNITS

PM	= PICOMETER	= 1×10^{-12} M	
NM	= NANOMETER	= 1×10^{-9} M	👉
μ M	= MICROMETER	= 1×10^{-6} M	👉
MM	= MILLIMETER	= 1×10^{-3} M	
M	= METER	= 1M	
KM	= KILOMETER	= 1×10^3 M	👉

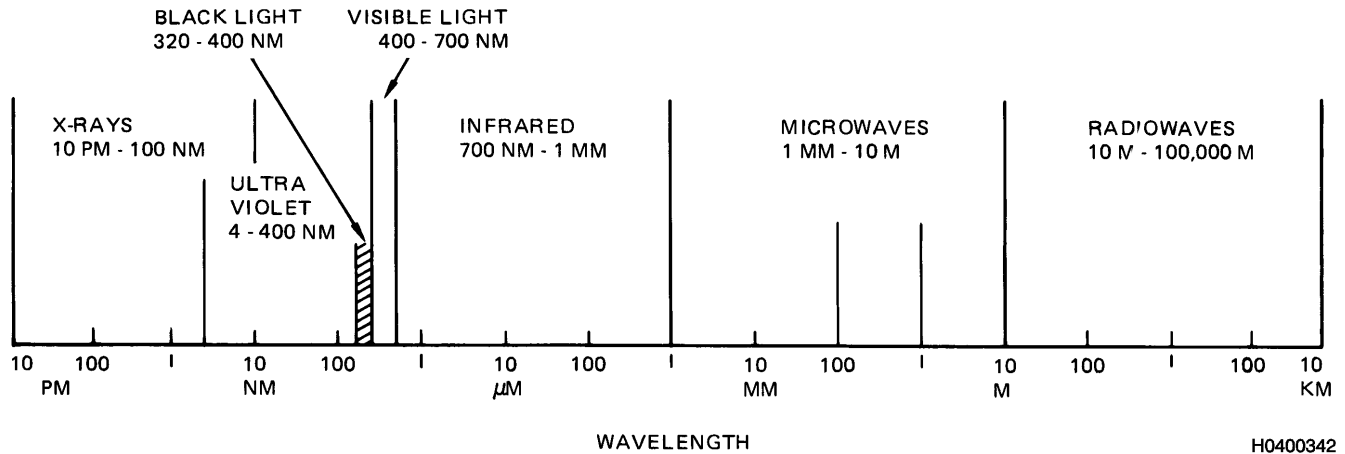


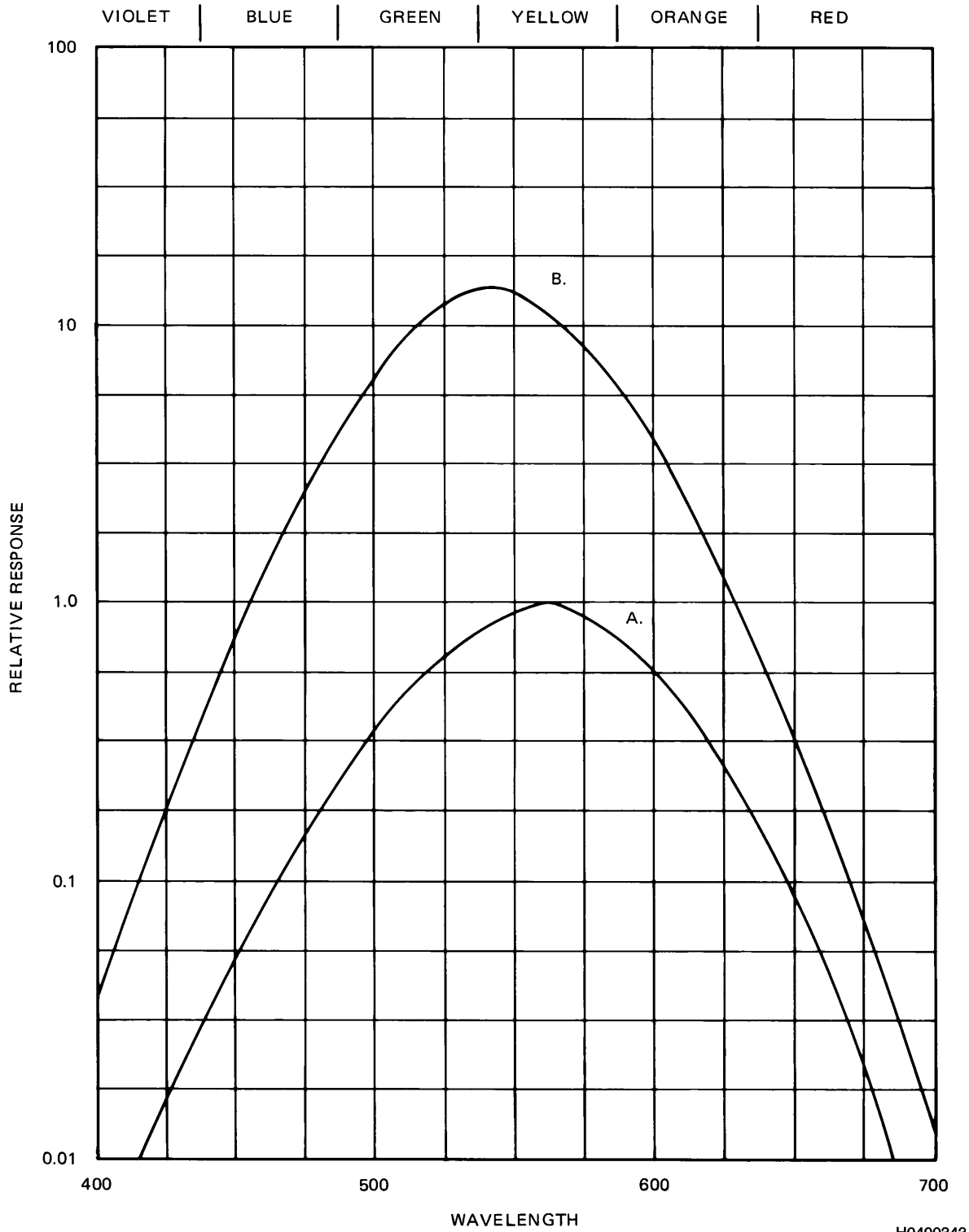
Figure 2-27. Electromagnetic Spectrum Shows the Relatively Narrow Band of UV-A

2.5.4.1.2 The Interaction of UV-A Radiation and Fluorescent Materials.

CAUTION

Some optical plastics used in eyeglass lenses can fluoresce, causing a loss of eye sensitivity when exposed to ultra-violet light. UV filtering safety glasses, goggles, or face shields SHALL be worn over such glasses to block the UV-A.

Fluorescence is the ability of some chemical compounds to emit visible light when exposed to near ultraviolet radiation. When fluorescent materials are energized by ultraviolet radiation, visible light is emitted. The color of the emitted light depends upon the material. Each type emits a specific wavelength ranging from violet (400 nm) to red (700 nm). Factors in selecting a fluorescent dye are a) the color emitted, and b) the intensity of emitted fluorescent light. The most frequently used dyes emit a yellow-green light in the wavelength band of 510 to 560 nm. This color is chosen since the human eye has its highest response to wavelengths in the 550 nm range. The relative response of a typical human eye compared to various wavelengths of visible light using two different lighting conditions are shown (Figure 2-28). Curve A at 100 lumens (100-foot-candles) is typical of a well-lighted inspection bench. Curve B at 2 lumens (2-foot candles) is the maximum white light level allowed in a fluorescent penetrant inspection booth. Under the darkened condition, the sensitivity of the eye increases about 30 times and shifts slightly to the blue region. At a light level of 2 lumens, it is possible for the eye to see some light wavelengths below 400 nm and above 700 nm.



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Figure 2-28. Relative Response of a Typical Human Eye to Visible Light at Two Different Light Levels, (A) 100 Lumens, and (B) 2.0 Lumens

2.5.4.1.3 UV-A Intensity and Ambient Light Requirements.

CAUTION

When performing portable fluorescent penetrant inspection, a dark colored canvas or photographers black cloth SHALL be used to darken the area during the examination. Every effort should be made to reduce ambient light conditions to below 2 foot-candles.

The adequacy of a UV-A lamp for fluorescent penetrant inspection is determined by measuring the intensity of the UV-A with a UV-A radiometer placed at a distance of 15-inches from the front or outside surface of the UV-A source filter. UV-A lamps used in the rinse stations are NOT required to meet these requirements since they are not used to inspect for cracks in parts. The ambient white light at the inspection surface SHALL NOT exceed 2-foot-candles. Ambient white light SHALL be measured with a white light meter with the UV-A lamps on.

2.5.4.1.4 Measurement of Intensity (Irradiance).

NOTE

Digital UV-A radiometers SHALL be used when measuring LED lamp intensities.

2.5.4.1.4.1 Measurement Devices. Ultraviolet light is electromagnetic radiation and is measured in units of energy per time, namely the unit of watt (W). Digital UV-A radiometers are currently the most commonly used instrument for conducting this measurement. Radiometers typically measure the energy of ultraviolet light in units of energy per time per area, i.e. watts per square meter or microwatts per square centimeter where one watt per square meter (W/m^2) equals 100 micro-watts per square centimeter ($\mu W/cm^2$). Care SHALL be exercised to assure the instrument used for this measurement is designed for the UV-A range with the peak at 365-nm.

2.5.4.1.4.2 Guidelines for UV-A Intensity Measurement. There are a few precautions to be observed when using UV-A intensity measuring instruments.

2.5.4.1.4.2.1 Some instruments have selectable ranges, and the proper range for the intensity being measured SHALL be used. The range selector may be changed while under the UV-A lamp.

2.5.4.1.4.2.1.1 UV-A lamp beam intensity and projected profile requirements are stated in TO 33B-1-2 WP 103 00.

2.5.4.1.4.2.2 The sensing element should be at the location and orientation of the part surface to be inspected. Some instruments have detachable sensors that may be placed directly on the part surface.

2.5.4.1.4.2.3 White light does not affect the reading of the instrument.

2.5.4.1.5 Variables in UV-A Sources. Mercury vapor arc lamps that will be used periodically during the day SHOULD be allowed to remain on until their last use of the day. This practice will extend the useful bulb life. This does not apply to Micro Gas Discharge (MGD) or Light Emitting Diode (LED) lamps.

2.5.4.1.5.1 Manufacturing Variations - UV-A bulbs are manufactured for other industrial applications. Non-destructive inspection (NDI) uses only a small portion of this production. The primary users do not require a specific output or consistency between bulbs. Consequently, new bulbs may vary by as much as 50-percent in their initial output. This means that of two new bulbs, one may have an intensity that is double that of the other without either being defective.

2.5.4.1.5.2 Line Voltage Variations -UV-A intensity varies almost linearly with line voltage. A common misconception is the bulb ballast or transformer will regulate line variations. Below approximately 90-volts, the lamps will not sustain the mercury arc and the lamp will extinguish, and will not restart until it has cooled. Lamps should be connected to stable power sources. If none are available and line voltage fluctuates, a constant potential transformer should be used.

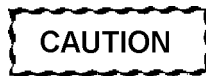
2.5.4.1.5.3 Service and Aging Variations -During use, dust and dirt will collect on both the bulb face and filter. Even small amounts will reduce the intensity and, if allowed to build up, can result in as much as a 50-percent decrease in ultraviolet

radiation output. The bulb face and filter SHALL be kept clean. The output of UV-A bulbs will also vary due to changes in operating characteristics, as the operating hours add up and the bulb ages, the intensity will gradually decrease and will decrease the bulbs output. Of greater significance is the number of bulb starts. A single start can equate to 2 or 3-hours of continuous use on operating life.

2.5.4.1.6 UV-A Lamp Safety. Ultraviolet radiation below 320 nm can be hazardous and may cause permanent effects. The output of a UV-A bulb is principally at 365 nm and the amount of radiation at shorter wavelengths rapidly falls off. The amount of radiation emitted at or below 320 nm is typically less than 1-percent; however, this quantity is enough to require a filter. Germicidal, sun tanning, and mineral light bulbs that emit short and medium wavelength ultraviolet light SHALL NOT be used for penetrant inspection. Ultraviolet light filtering safety eyewear and gloves shall be used to minimize potential detrimental health effects.

2.5.4.1.6.1 Eyeball Fluorescence under Ultraviolet Radiation. The fluid in the eye will fluoresce when exposed to ultraviolet radiation. An operator may experience this phenomenon as a clouding of the vision when the ultraviolet radiation is reflected into the operator's eyeball or if ultraviolet radiation is reflected from highly reflective surfaces. This phenomenon, often referred to as veiling glare, can usually be corrected by positioning the lamp so the radiation is not directed or reflected into the inspector's eye. The use of eyewear designed to protect the eyes from UV-A and UV-B will reduce this effect.

2.5.4.1.6.2 Restrictions on Eyeglasses.



Contact lenses, sunglasses, and glasses with photochromic lens that darken when exposed to sunlight SHALL NOT be worn when performing fluorescent penetrant inspection.

Sunglasses reduce the amount of visible light radiating from a fluorescing indication and faint indications may not be seen. Photochromic lens will darken when exposed to UV-A and reduce the ability to see small indications. Furthermore, eyeglass frames that fluoresce under UV-A can cause glare or unnecessary fluorescent background illumination and should not be used in the inspection booth.

2.5.4.2 Ambient Visible Light.

2.5.4.2.1 Requirements. Inspection of a part for fluorescent penetrant indications with UV-A lamps SHALL always be performed under the lowest possible level of ambient light. This increases the contrast between the light emitted from the indication and the background. A low level of visible ambient light is critical for maintaining the sensitivity of the inspection. Ambient light in stationary inspection system booths SHALL NOT exceed 2 foot-candles. If a stationary inspection booth is not adequate or appropriate, other provisions SHALL be made.

2.5.4.2.2 Measurement of Ambient Visible Light. Visible light is measured using photometers or light meters. The light meter responds to electromagnetic energy with wavelengths of approximately 380 to 750 nm. This range extends into the longer wavelength ultraviolet and shorter wavelength infrared ranges. Precise measurement is possible with filters excluding black light and infrared radiation. The unit of measurement is the foot-candle. Another term often used to measure light intensity is the lux, which equals 1-lumen per square meter of surface area. One foot-candle equals approximately 10 lux. Measurement of ambient white light SHALL be performed in stationary inspection booths at the required intervals defined in TO 33B-1-2, WP 103 00 Table 1. Ambient white light SHALL also be performed prior to portable inspection. Ambient light measurements SHALL be performed with the overhead UV-A lamps on. Due to the response curve of silicon photodiodes and variability in filters used in meter construction, visible light meters are not suitable for measuring the emission of visible light from UV-A sources.

2.5.4.2.3 White Light Requirements for Type II Penetrant Inspection. For inspecting parts that have been processed with visible-dye penetrant (Type II), the lighting system in the viewing area SHALL provide at least 100-foot-candles (1000 lux) of visible white light at the examination surface.

2.5.5 Inspection Conditions.

2.5.5.1 Dark Adaptation.

CAUTION

An inspector entering a darkened area SHALL allow at least 1 minute for dark adaptation before examining parts. Furthermore, wearing clothing which fluoresces under ultraviolet light SHALL NOT be permitted during the performance of fluorescent penetrant inspection as it may raise the ambient white light in the inspection area to an unacceptable level.

The human eye becomes approximately 30-times more sensitive to light under dark conditions. This increased sensitivity gradually occurs when the light conditions change from light to dark. When first entering a dark area from a lighted area, little or nothing can be seen. During dark adaptation the human eye begins to adjust to the lower light levels in two ways. First, the pupil of the eye must widen to admit additional light. Second, the retina of the eye becomes more sensitive during dark adaptation as the retina switches from the cone to the rod receptors. A dark adaptation time of 1 minute is sufficient for fluorescent penetrant inspection with UV-A lamps. The human eye contains a protective mechanism that further complicates dark adaptation. The pupil of the eye responds very rapidly to bright light. A very short, bright light exposure cancels the slowly acquired dark adaptation. Time for dark adaptation SHALL be allowed whenever an inspector enters the darkened station or is exposed to bright ambient light. A timer capable of measuring this time period SHALL be visibly or audibly available within the darkened area.

2.5.5.2 Cleanliness. The inspection area and the hands/gloves and clothing of the inspector SHALL be clean and free of extraneous penetrant material. Non-relevant indications may be formed when parts contact extraneous penetrants. In addition, the fluorescence from the penetrant will raise the ambient light level, thus reducing sensitivity.

2.5.6 Evaluating Indications.

2.5.6.1 Evaluating and Interpreting Relevant and Non-relevant Indications. A distinction must be made between relevant indications, non-relevant indications, discontinuities, and flaws or defects. A relevant indication is one resulting from a discontinuity. A non-relevant indication can result from an intentional change in part shape such as threads or small radii, or may be caused by improper or careless processing procedures. Non-relevant indications are of concern because they may mask or cover a true discontinuity indication. A discontinuity is an unintentional change in part surface or physical condition such as tooling marks, scratches or gouges, cracks, seams, laps, and porosity. A discontinuity may or may not affect the serviceability of the part. If the discontinuity reduces or interferes with the serviceability, it is classified as a flaw or defect. It is possible for a part to contain multiple indications that may be any combination of non-relevant discontinuities not affecting serviceability and defects requiring corrective action.

2.5.6.2 Inspectors Interpretation Responsibility. NDI personnel SHALL be capable of interpreting indications and evaluating discontinuities in accordance with the specifications and procedures for the inspection process in use. They are not normally responsible for disposition decisions on flawed parts, but they must report the type, location, and approximate size of any flaws present. Acceptance, rework or repair, and rejection limits are contained in the repair manuals and are the responsibility of the applicable work center.

2.5.6.3 Appearance of Indications. The size and shape of the discontinuity, the type of penetrant system, processing technique, type of developer, and the length of developer dwell influence the appearance of penetrant indications. These factors hold true for all types and forms of material and apply to both large and small parts.

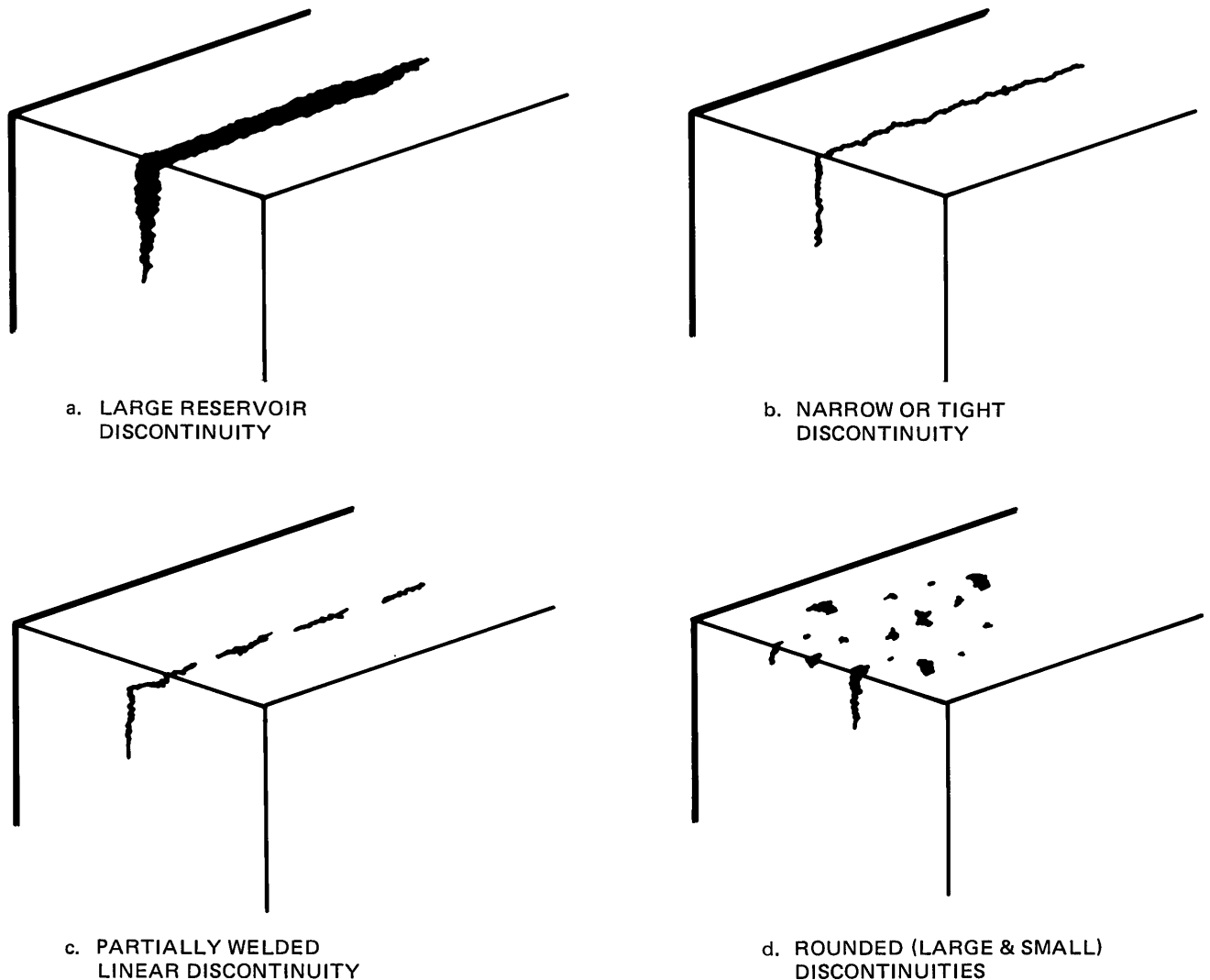
2.5.6.4 Classification of Discontinuity Indications.

NOTE

Remember, although an indication may signify a discontinuity in the test part, an indication is not always a sign of a defect. The responsible engineering authority SHALL make a determination if a discontinuity will be classified as a defect.

There are a number of ways of classifying discontinuities, such as appearance of the indication, its cause, material, and service conditions. The method of classification used depends upon the test method, the use of the parts, and the original designer. Many of the NDI application manuals, which are usually prepared by the original manufacturer, contain several discontinuity classifications in the same manual. Some of the indication types are discussed in the following paragraphs.

2.5.6.4.1 Continuous Linear Indications. Linear penetrant indications are caused by discontinuities such as cracks, seams, or laps. The width and brightness of the indication depend upon the volume of entrapped penetrant. The indication may be fairly straight or may have some curvature depending on how the discontinuity was formed. Also, the edges may be jagged or smooth, where the discontinuity meets the part surface. The surface appearance and a cross-section through a linear discontinuity with a large reservoir is shown ([Figure 2-29, \(a\)](#)). A narrow or tight linear discontinuity is also shown ([Figure 2-29, \(b\)](#)).



H0400344

Figure 2-29. Typical Penetrant Indications (a, b, c, d)

2.5.6.4.2 Intermittent Linear Indications. Intermittent linear indications are caused by the same discontinuities that form continuous linear indications; however, either a subsequent process or service use has partially sealed the surface opening. This occurs in forging laps or where the part has been subjected to a mechanical smearing action. A sub-surface discontinuity that intermittently breaks the surface for its entire length or a partially filled seam will also produce an intermittent linear indication as shown in [Figure 2-29](#), (c).

2.5.6.4.3 Round or Dot Indications. Round indications are characterized as having a length and width of approximately equal dimensions. Porosity or relatively small areas of unsoundness in metal components usually form rounded indications; however, the actual surface opening may be irregular in shape. Deep discontinuities, such as weld crater cracks, may appear rounded due to the large volume of entrapped penetrant. The appearance of large and small rounded indications is reflected in [Figure 2-29](#), (d).

2.5.6.4.4 Manufacturing Discontinuities. Many discontinuities result from manufacturing and repair processes. These will probably be detected each time the part is reinspected. The NDI inspector must, therefore, be familiar with their appearance and cause, in order to make valid interpretations of inspection results. Some of the common types of manufacturing discontinuities are described in the following paragraphs.

2.5.6.4.4.1 Porosity. Porosity is common to all cast parts, particularly aluminum and magnesium. Porosity occurs when gases are entrapped in the molten metal during pouring and solidification and may also occur during welding. It does not always break the surface, and internal porosity is not detected by penetrant inspection. Porosity can be very small and distributed throughout the material, in which case, it is called microporosity or you may see larger pores, which are called macroporosity. Microporosity may or may not cause a penetrant indication. In castings, porosity is usually not considered a defect, unless it is extensive enough to cause a structural weakness or allow the leakage of a fluid intended to be contained by the casting.

2.5.6.4.4.2 Inclusions. Inclusions are particles of foreign material, usually slag, oxides, sulfides, or silicates trapped in the metal during solidification. If the material is mechanically worked into plate, sheet, or bar, the inclusions will be elongated by the forming operations. They are not usually at the part surface but may become exposed by subsequent machining. Since inclusions are solid foreign matter, they will not form penetrant indications unless the foreign material is porous. Inclusions are usually considered defects only when they are open to the surface, have a measurable length, and are located in a critical area.

2.5.6.4.4.3 Seams. Seams occur in rolled bar stock or parts machined from bar stock. They are inclusions, porosity, or more commonly, metal folds that have been elongated by the rolling process during fabrication. They are long, straight discontinuities running parallel to the direction of mechanical working. If the seams contain foreign material, they may produce no indications, or very faint indications. They may be classified as defects depending on size and location.

2.5.6.4.4.4 Forging Laps. Forging laps are formed when a portion of the metal is creased and folded over during the forging operation. They produce a wavy, irregular, linear indication, which may be faint or intermittent, since the lap breaks the surface at an angle and the edges may be partially welded. They may or may not be considered a defect, depending on size and location.

2.5.6.4.4.5 Flash-Line Cracking. Forging flash is the line of excess metal extruded into the space at the junction between the top and bottom dies. Cracking can occur when this excess metal is removed causing the linear type of indications. The cracking always occurs along and within the trimming marks.

2.5.6.4.4.6 Extrusion Tears. Extrusion involves forcing a metal through a die to produce a desired shape. This process is similar to squeezing toothpaste out of a tube. If the die lip has a nick, burr or lump of oxide, the die can produce tears in the extruded part. Extrusion tears are usually short linear defects perpendicular to the extrusion direction.

2.5.6.4.4.7 Thermal Cracks. When metals are subjected to a high temperature, localized stresses can occur due to unequal heating or cooling, restricted movement within the part, or unequal cross-section. Cracking will occur when the stresses exceed the tensile strength of the material. There are several types of thermal cracking depending upon the heating process.

2.5.6.4.4.7.1 Grinding Cracks. Grinding of hardened surfaces frequently introduces surface cracks. Localized overheating due to insufficient or poor coolant, improper grinding wheel, too rapid feed or too heavy a cut causes these thermal cracks. The cracks are shallow and sharp at the root, generally occur at right angles to the direction of grinding, and usually but not always, occur in multiples. Grinding cracks are considered defects since they reduce the fatigue strength.

2.5.6.4.4.7.2 Heat Treat Cracks. Heat-treat or quench cracks form as a result of unequal heating or cooling within a part. The cracks are deep, usually forked, and seldom form a pattern. These cracks are considered defects.

2.5.6.4.4.7.3 Weld Cracks. Welds can contain a number of discontinuities detectable by penetrant. They may be due to lack of penetration, lack of fusion, heating or quenching cracks in the weld bead and heat affected zone, and grinding cracks occurring during removal of the weld crown. Crack-like discontinuities are considered defects. Two typical examples are, weld grinding cracks; and, shrinkage or quench crack.

2.5.6.4.5 Service Induced Discontinuities. The most frequently encountered service discontinuities detected by penetrant inspection are fatigue cracks. Stress corrosion and overload cracking are also common. Overload fractures occur when the stress exceeds the tensile strength of the part. This is greater than the yield point, and the fracture is accompanied by some distortion. Cracks caused by overloading are relatively large and are further magnified by distortion, making them easy to detect visually without penetrant inspection.

2.5.6.4.5.1 Fatigue Cracking. Repeated or cyclic loading below the yield strength of the metal causes fatigue cracks. They initiate after a large number of load cycles usually at a surface imperfection such as a pit, scratch, tool mark, or at sharp

change in cross-section. The initial crack is very small and forms a quarter or half-arc around the initiation point and then stops. After an additional number of load cycles, the crack grows slightly. This growth-arrest cycle produces a characteristic pattern on the fracture face, termed clamshell or beach mark pattern. Fatigue cracks have many common features. They occur in regions of high stress, are perpendicular to the direction of principal stress at their origin, and are transgranular. A good example of a fatigue crack is seen in [Figure 2-30](#). Transgranular means the cracking progresses through or across the grains of metal rather than around them. Fatigue cracking occurs on a wide variety of parts and is considered a defect. It will continue to grow in-service, and the rate of growth increases as it becomes larger.

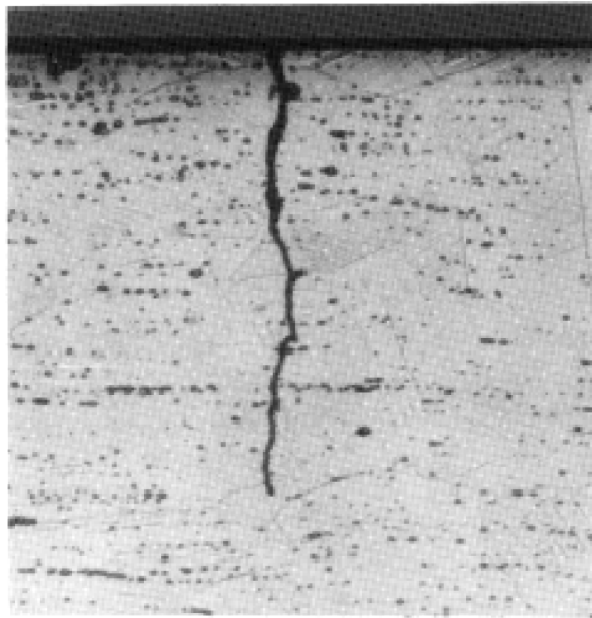


Figure 2-30. Micrograph of a Cross-Section Through a Fatigue Crack Showing the Transgranular Progression of the Crack

2.5.6.4.5.2 Stress-Corrosion Cracking. Stress-corrosion cracking is caused by a combination of stress and corrosion action. The stress may be either from service loads or a residual stress in the part. The residual stress can cause cracking of a part never in service. Stress-corrosion cracks have many of the characteristics of fatigue cracks. They occur in high stress areas at right angles to the stress and will grow in-service. Stress corrosion cracking may form a network of fine spider web-like cracks on the part surface. Penetrant indications of stress-corrosion cracks can also appear identical to indications of fatigue cracks. It is not always possible to distinguish between fatigue cracks and stress corrosion cracks from their surface appearance. Metallurgical examination is required to identify stress corrosion from fatigue cracks, since cross-sectioning will show stress-corrosion cracks are intergranular (meaning they propagate between the metal grains) whereas fatigue cracks are transgranular (they propagate through the metal grains). A micrograph of a stress-corrosion crack is shown in [Figure 2-31](#). As with fatigue cracks, it is important to know the history or circumstances associated with the occurrence of the stress-corrosion cracking. Depending upon the service of the part, fatigue cracks may be free of contamination and may be easily detected with penetrant testing or they may be filled with contamination or under such high residual compressive stress they are impossible to detect with penetrant. Stress-corrosion cracks may have very little or a lot of corrosion products trapped in the cracks. The amount of corrosion product present significantly affects the detectability of this type of cracking. As with fatigue cracks, certain types of stress-corrosion cracking may not be detectable with penetrant methods. Extended dwell times may also be required to detect stress-corrosion cracking.



Figure 2-31. Micrograph of a Cross-Section Through a Stress-Corrosion Crack

2.5.6.4.5.3 Corrosion. The penetrant inspection method is occasionally used to detect corrosion. Corrosion usually attacks the material at the grain boundaries faster than at the interior of the grains and forms a network of very fine cracks. Corrosion may also be found as pitting on part surfaces. In the early stages, the crack or pitting are visible only under 10X or greater magnification. Penetrant indications of intergranular corrosion or surface pitting appear as a residual background that can only be resolved under magnification. Developer is not used when evaluating a penetrant indication using a magnifying glass. Penetrant inspection is often used to monitor the surface for adequacy of corrosion removal by grinding. Caution SHALL be exercised, since the mechanical removal causes smearing, which may obscure indications of remaining corrosion. In monitoring corrosion grind-out areas, a developer SHALL not be used. Following removal of excess surface penetrant, the area is examined using a low-power magnifying glass (3X to 5X). The examination SHALL be repeated after a minimum 5- minute dwell in lieu of developer. When the corrosion is no longer detected, the inspection process SHALL be repeated using nonaqueous developer.

2.5.6.5 Evaluation of Indications (Bleed-Back Method). Indications can be indistinct and blurred while still being highly visible. The following method may be used to verify and evaluate the type of indication. Lightly dampen a clean rag or cotton swab with an approved fast drying solvent, such as Isopropyl Alcohol. Carefully wipe the indication area only once with the solvent dampened rag or swab. After the solvent has evaporated, examine the bare surface with a 3X to 5X magnifying glass and watch the indication as it begins and continues to develop without developer applied. Evaluation of penetrant indications with a magnifying glass SHALL be accomplished with the developer removed. The developer will blur and enlarge the indication. The initial evaluation SHALL be done at low magnification (3X to 5X), with higher magnification (10X) used only after the indication has been located. If the indication cannot be located, spray a very light layer of nonaqueous developer over the area and watch the indication as it begins and continues to develop. If no penetrant bleed-out or surface imperfection can be seen, the original indication could have been non-relevant, possibly due to improper processing.

2.5.6.6 Photography of Indications.

2.5.6.6.1 General. Photography can be a good method of producing a permanent record of penetrant indications. Photography film and digital, can provide a very descriptive record since they show both the indication size and location on the part. They are permanent, reproducible, and the required equipment is available. Digital photography allows for rapid reproducibility and transportability of the imagery data, provides for very rapid optimization of exposure parameters and is

much faster in terms of processing time. Photographs made at different times will vary due to a number of factors, such as changes in part position, camera position, UV-A intensity and filters used.

2.5.6.6.2 Camera Equipment. When photographing penetrant indications, which are generally very small, the camera must be held close to the object. This requires, at a minimum, a set of close-up (macro) lenses. Tripod or other means of holding the camera steady, and a cable release shutter are recommended methods to reduce blurring caused by camera motion.

2.5.6.6.2.1 Filters. When compared to the human eye digital camera sensors have a higher response to ultraviolet light. When photographing fluorescent indications, the ultraviolet light must be removed or filtered to obtain a usable photograph. The basic filter used is a No. 2B. (The name Wratten is often associated with the filter numbers, after the man who devised the numbering system.) The 2B filter will absorb the invisible ultraviolet while passing the visible blue light. This approach provides a photograph representative of what the eye sees. Color balance will be normal and the part will appear as a blue outline with the fluorescent indication appearing as bright yellow-green as normally seen. With black and white film or digital images, the part will be outlined and the indication will appear as a white line or dots. Some developers that form a bright background decrease the contrast between the part and indication, which may be compensated for by using a 2E filter. The 2E filter reduces the background brightness without reducing the indication brightness. To provide an image of the part, the part may be illuminated with a very subdued white light while illuminating the indication with a UV-A lamp.

2.5.6.6.3 Camera Positioning. Penetrant indications are usually small. On large parts, it may not be possible to include the entire part in the photograph and still get acceptable detail on the indication. The camera must be moved in close to the indication, showing just enough of the part to adequately identify the location of the indication. When photographing penetrant indications, a through-the-lens viewing system is preferred. Cameras with a separate viewing lens will not include the exact area when making close-up photographs. Compensate for this by shifting the viewer aiming spot, the distance between the lens and viewer opening.

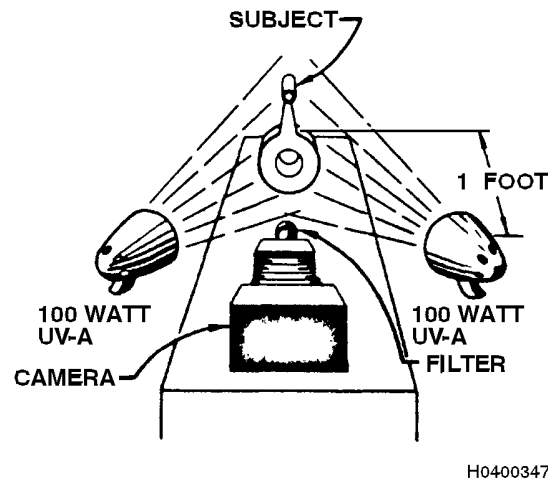


Figure 2-32. Location of Camera and Lights for Photographing Fluorescent Indications

2.5.6.6.4 Photographic Lighting. The maximum possible amount of UV-A energy SHALL be used to enhance the indication. The usual procedure is to use two UV-A lamps placed at equal distances on each side of the indication and position the camera in the middle (Figure 2-32). This procedure provides equal light intensity across the length of the indication. The UV-A lamps SHALL be positioned so neither the direct beams, nor reflections from them, enter the camera. Tubular (fluorescent) UV-A bulbs, and many ultraviolet-light guide sources emit more visible blue light than high pressure, mercury bulbs. Therefore, a No. 2E filter will produce a more natural photograph when fluorescent UV-A are used.

2.5.6.6.4.1 Lens Opening, Exposure, and Bracketing.

CAUTION

Always use the smallest lens opening (largest F-stop number) possible to get an acceptable depth of field to keep the entire part in focus.

Close-up photography requires care in selecting the lens opening to obtain an acceptable depth of field. Depth of field is the distance range that is in focus. Lens openings are called F-stops with larger numbers indicating a smaller lens opening, as the lens opening increases, (smaller F-stop numbers), the depth of field decreases. The lens opening number should be higher than F5.6 for most close photography of this type as stated. Stop numbers of F6 or smaller will result in portions of the picture being out of focus. Close-up photography of fluorescent indications may require a number of exposures to obtain optimum results. Therefore three exposures should be made: the first at the meter indicated F-stop number; the second at two F-stop numbers under the meter reading; and the third at two F-stop numbers over the meter indicated number. A fourth exposure may be required at an intermediate setting. With very large or very small indications, the optimum lens opening may be three or four F-stop numbers off the indicated value.

SECTION VI PROCESS CONTROL OF LIQUID PENETRANT INSPECTION

2.6 LIQUID PENETRANT PROCESS CONTROL.

2.6.1 General. This section provides basic level information necessary to assure a high quality performance from the penetrant inspection system. Specific procedures to accomplish process control of the penetrant system are published in TO 33B-1-2 WP 102 00.

2.6.2 Need for Process Quality.

CAUTION

The process materials and equipment SHALL be periodically tested and inspected to be sure they are all functioning properly.

Materials and process deficiencies are not always obvious. It is not easily determined if a penetrant has lost its ability to penetrate into a given flaw. Penetrant inspection, as well as all other nondestructive inspection processes, is not a perfect process. Flaws can be present and not be indicated for a number of reasons. The two main reasons for discrepancies in inspection results are:

- Substandard inspection materials due to either receipt of bad material from the manufacturer or degradation in storage or service.
- Process deviations in equipment, procedures, or operating conditions.

2.6.3 Why Test New Materials. Penetrant materials are subjected to extensive testing during their formulation to assure their proper composition. However, materials not performing satisfactorily can still be received. In a number of instances, the discrepancies in performance have not been detected until a number of parts have been processed. Considerable effort must then be expended to locate and reinspect the suspect parts. Unsatisfactory materials can result from a number of causes. The penetrant supplier may inadvertently omit an ingredient or a process. An ingredient with similar characteristics may be substituted if the original material is unavailable. The substitution of ingredients may occur at the penetrant formulator's supplier.

2.6.4 Why Test In-Use Materials. Some inspection processes use the penetrant materials one time with no attempt to recover the excess. The materials are usually applied by spraying, and only enough material is applied to perform the test. The materials are stored in closed containers until they are used. These processes minimize the possibility of material contamination or degradation during use. More often, however, the materials are used in open tanks or open containers. When the

immersion method is used, the surplus materials are allowed to drain from the part back into the tank. When penetrants are applied by brushing, the brush is alternately stroking the part surface and being immersed in the container. Both methods provide numerous opportunities for contamination and deterioration. Materials handled in this manner SHALL be checked periodically to be sure they are functioning properly.

2.6.5 Causes of Material Degradation.

2.6.5.1 Materials Contamination. Materials contamination is a primary source of penetrant system performance degradation. There are a number of contaminating materials and their effect on performance depends upon the contaminant type. Some of the common contaminants frequently encountered are:

- Water - Probably the most common type of contaminant. This can occur by careless or improper rinsing or carry over from other parts.
- Organic materials - Paint, lubricants, oils, greases, and sealant are other sources of contamination. If not removed from parts during precleaning, these materials can dissolve in the penetrant and react with or dilute it so it loses some or all of its ability to function.
- Organic solvents - Degreaser fluid, cleaning solvent, gasoline, and antifreeze solution are common types of solvent contaminants. These materials dissolve in the penetrant and reduce its effectiveness in proportion to the amount present. A small change in performance is usually not noticeable (5-percent or less of the total volume). The method of entry into penetrant is usually carry-over on the interior cavities of the part.
- Dirt, soil, other insoluble solids - Soil/solid contamination can be carried into the penetrant, emulsifier, and developer as a result of improper pre-cleaning and carry-over from other parts. Another common source of soil contamination occurs when the dwell stations are used to store parts. Most dwell stations have drain pans, which return the effluent back to the immersion tanks. Any soil falling from unclean parts into the drain pan will be washed into the tank with the drain effluent.
- Acid and alkaline materials - Acid and alkaline contamination is extremely serious. They react with the penetrant to destroy fluorescence brightness even when present in fairly small quantities. They are usually residues from etching, plating or the cleaning processes.
- Penetrant - Penetrant is a normal contaminant of emulsifier in the postemulsifiable process. It can be carried in on penetrant covered parts during the penetrant dwell step. As the penetrant builds up in volume, it will gradually slow the emulsifying action, and if the level becomes high enough, the emulsification process will stop.

2.6.5.2 Evaporation Losses. Penetrant materials used in open tanks are continuously undergoing evaporation. The rate of evaporation is increased with warmer temperatures and large tank surface areas. Evaporation losses of penetrant result in an increase in viscosity, thus slowing penetration and emulsification. Evaporation of water washable penetrant may slow or speed washability, depending on the penetrant formula. Evaporation losses in developer solutions increase the concentration, which produces a heavier coating that may mask smaller indications. Since evaporation losses take place gradually, performance change may become significant before it is noticed.

2.6.5.3 Heat Degradation. Penetrants, especially fluorescent penetrants, are sensitive to elevated temperatures. Exposing penetrants to temperatures over 140°F (60°C) can reduce the fluorescence; and temperatures over 250°F (121°C) may destroy the penetrant completely. High temperatures also speed evaporation of the volatile components of penetrants, causing undesired performance changes. High temperature exposure of penetrants can occur from the following:

- Immersion of heated or hot parts.
- Inspection of hot surfaces resulting from exposure to the sun, such as flight-line aircraft.
- Improper storage of penetrant materials (such as in direct sunlight and high temperature storage) before being placed in use.
- Excessive exposure to heat in drying ovens.

2.6.5.4 Process Degradation. Not only do materials degrade, but equipment and procedures (other elements of the process) can deteriorate as well. UV-A bulbs and LEDs age, degrade, and also become dirty, reducing their output. Drying oven thermostats can be improperly set or may malfunction, resulting in excessive temperatures causing critical procedures to be performed incorrectly. Materials, equipment, and procedures SHALL be periodically audited during their service life to assure satisfactory process performance.

2.6.6 Establishing Work Center Process Control Intervals.



The MAXIMUM allowed process control intervals are established in TO 33B-1-2 WP 102 00. Each activity SHALL set inspection intervals based on their workloads. Laboratories SHALL use the guidelines listed below to establish their process control requirements and intervals. The inspection intervals SHALL be documented as discussed in [Paragraph 1.5.5](#).

One of the factors influencing the degradation of a penetrant process (materials, equipment, and procedures) is the volume of parts being processed. The opportunities for materials contamination, drag-out, equipment malfunction, and procedure deviation are directly proportional to the number of parts being inspected. Equipment and process control inspection intervals vary depending upon the specific item to be checked. Many items will degrade on a time rather than a use basis. Since there is no uniformity in workload between activities, a single calendar schedule cannot be established. The process and equipment SHALL be inspected at established intervals in accordance with TO 33B-1-2.

2.6.7 Process Control Equipment. The performance of liquid penetrant systems depends on processing material quality, including the pre-cleaning chemicals, liquid penetrant, emulsifier and developer, plus the continued proper functioning of the several processing stages. A sudden undetected deterioration of one of the processing chemicals or malfunction in one of the stages may result in a defect escape and the acceptance of a defect containing part. The penetrant operator must be alerted to the sudden change or deterioration in materials and in equipment ([Paragraph 2.3.7](#)) as soon as possible and certainly before processing a substantial quantity of parts. The following paragraphs describe the various configurations of process monitoring devices available that are often used in determining the performance of the penetrant system.

2.6.7.1 Penetrant System Monitor (PSM).



The PSM panel SHALL NOT be used as a substitute for the cracked-chrome plate panels. The PSM panels are authorized for use with automatic and semi-automatic spray systems used in some depot laboratories when directed by the Depot NDI Manager.

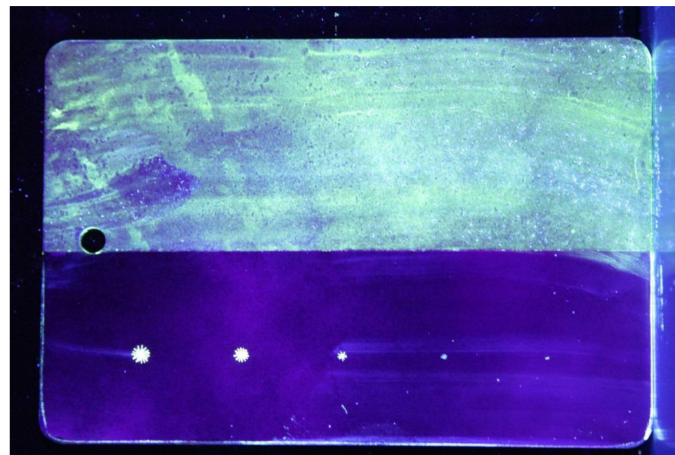
One example of a process-monitoring device is the Penetrant System Monitor (PSM), also known as the “star burst” panel. The PSM is alternatively specified as Pratt and Whitney TAM Panel 146040, Sherwin Company P/N PSM-5 and Magnaflux Company P/N 198055. The PSM is especially suitable for high volume, semi-automated, and fully automated depot systems. It is intended for use as a daily or weekly monitor of the entire penetrant process. When properly used, the PSM will signal sudden changes affecting the integrity of a penetrant inspection process, changes that may have occurred in the materials, equipment, or procedures.

2.6.7.1.1 PSM Configuration.

CAUTION

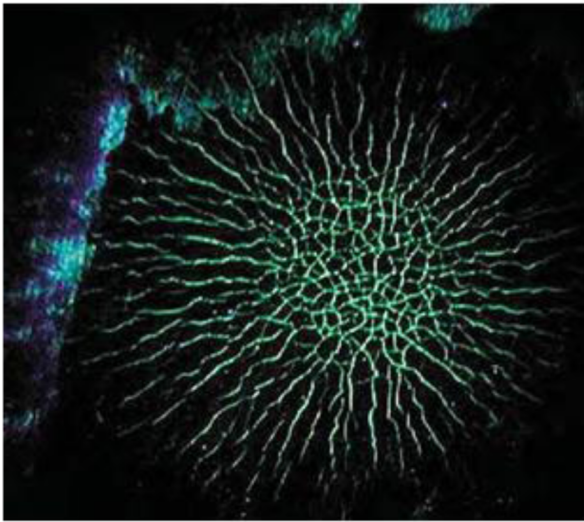
Careful and thorough ultrasonic cleaning of the PSM panels between uses is mandatory (TO 33B-1-2 WP 102 00). Use extreme care in handling and storing the panels. Do not drop, hit, or place undue mechanical stress on the test panels. Do not attempt to bend or straighten the test panels. Do not expose the test panels to temperatures above 212°F (100°C). Careful and thorough ultrasonic cleaning of all panels after each use is mandatory. Handle the panels with care. The panels are easily damaged by rough handling or when dropped. Panels indicating or showing evidence of damage SHALL be immediately replaced.

The PSM is a stainless steel panel measuring 4-inches wide by 6-inches long. A chrome-plated strip runs the length while the other side is a medium roughness, grit blasted surface. The chrome-plated strip contains five, evenly spaced, crack centers ([Figure 2-33](#) and [Figure 2-34](#)). The crack centers are in circular patterns varying in size from about 1/4-inch diameter down to about 1/32-inch diameter, and are arranged in order magnitude. The cracks radiate from the center in a star or sunburst pattern. No two panels are completely identical and crack patterns and sizes vary from panel to panel. Furthermore, the design of these panels has changed over time. In previous designs, the starburst cracks were formed by indenting the back side of the panel. In more recent designs, the starburst cracks are formed by laser ablation.

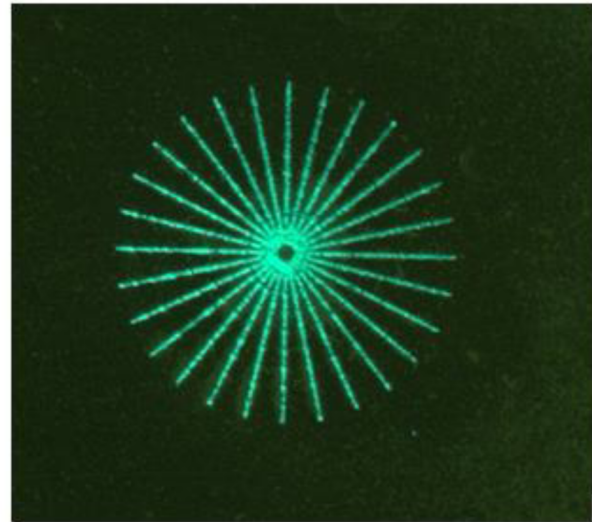


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Figure 2-33. Processed Starburst (PSM) Panel With Indications



Starburst Cracks Formed by Indentation



Starburst Cracks Formed by Laser Ablation

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Figure 2-34. Magnified View of Largest Manufactured Indication

2.6.7.1.2 Monitoring of Sensitivity and Removability Using the PSM (Starburst) Panel. The PSM can monitor the entire process because it can be processed directly in the working tanks along with production parts. In addition, the grit blasted strip will separately indicate the effectiveness of the removal process steps. One disadvantage is that small or gradual changes are not readily noticed. Furthermore, as with cracked chrome plate panels, the PSM indications deteriorate with handling and repeated use. Also, the PSM panel can retain large amounts of residual penetrant, so careful and thorough cleaning is mandatory.

2.6.7.2 Cracked-Chrome Panels. The cracked-chrome panel is used for the evaluation of a liquid penetrant system's discontinuity detection performance. They are typically used to provide a qualitative side-by-side comparison of liquid penetrant performance. Their primary advantage is that small or gradual changes are readily noticed. Generally, tests made with cracked-chrome panels do not provide useful information on the background color or fluorescence caused by surface roughness of test parts or on the ability of a liquid penetrant to reveal micro-cracks in the presence of severe background porosity indications. Cracked-chrome panel indications will deteriorate with handling and repeated use. The panels are supplied in sets of two, with the supplier matching the panels as closely as possible. One panel is reserved for use as a "reference" or "transfer" standard while the other is the "working" panel.

2.6.7.3 The cracked-chrome panel is made by burnishing a 2.80-inch wide brass or copper plate to a mirror finish, then electroplating a thin layer of chrome on this surface. The chrome layer is brittle and cracks can be generated in it by bending the panel over a curved form. Crack depth is controlled by the thickness of the chrome plating. Crack width is determined by the degree of deformation of the panel during bending and straightening and is not controlled. After the plate is chrome plated and cracked, it is cut in half, lengthwise to produce two panels containing symmetrical crack patterns in each panel. Since the cracks extend across the original panel, the two panels are provided as a set with each panel measuring 3.94-inches (100 mm) long and 1.38-inches (35 mm) wide. Panels are typically available with cracks of 10, 20, 30, and 50 microns. The 30 and 50- micron panels are most often used with low and medium sensitivity penetrants. The 10 and 20-micron panels are usually used with high and ultra-high sensitivity penetrants. The standard panel is the 20-micron panel.

2.6.7.4 Cleaning and Storage of PSM and Cracked-Chrome Panels.

CAUTION

Careful and thorough ultrasonic cleaning of cracked-chrome panels is mandatory.

See TO 33B-1-2 WP 102 00 for cleaning and storage requirements for PSM and Cracked-Chrome panels.

2.6.8 Control of New Materials.

2.6.8.1 Approved Materials. With the exception of solvent removers only penetrant materials listed on the latest version of qualified products database (QPD) for SAE AMS 2644, may be procured and used. QPD can be found on website <http://quicksearch.dla.mil/>. Search for QPL-AMS2644, then select "Qualification" to gain access.

2.6.8.2 Provisions for Procurement of New Materials. Penetrant system material procurement SHALL meet the following requirements:

- Materials SHALL comply with the current version of SAE AMS 2644.
- Except for solvent removers, bidders SHALL have material listed (or approved for listing) on the most current revision of QPD SAE AMS 2644.
- Contract and special purchase orders for procurement of materials SHALL require a certified test report from the manufacturer as required by SAE AMS 2644.
- Materials listed on QPD SAE AMS 2644 and centrally procured using generic national stock numbers (NSNs) need not comply with the certified test report and quality conformance sampling requirement.
- All penetrant materials shall be tested for sensitivity and removability performance in accordance with [Paragraph 2.6.9](#) and TO 33B-1-2 WP 102 prior to introduction into the inspection process. Depot facilities may use alternate defect specimens (e.g., fatigue crack specimens) instead of cracked chrome panels to evaluate material performance.
- Aerosol (penetrant and developer) products shall also require sensitivity and removability testing in accordance with the requirements of [Paragraph 2.6.9](#) and TO 33B-1-2 WP 102 prior to introduction into the inspection process

2.6.8.3 Sampling of Newly Received Materials.

2.6.8.3.1 General. Two samples are required from each batch or lot of penetrant, emulsifier or remover, and/or wet and dry developer when received. Only one additional sample will be required if the supplier has submitted a quality conformance sample. Either one or two samples SHALL be taken from each batch or lot of penetrant, emulsifier and remover, and wet and dry developer, when received and prior to use. One sample, either from the supplier or locally taken, will be used to verify the Quality Conformance. The second sample, which may be larger than the first, will be retained by the using activities as a reference standard for periodic process performance tests.

NOTE

For aerosol products, a spray can of retained, in-use material shall be used as the reference for comparison to the newly received material.

2.6.8.3.2 Sample Size.

2.6.8.3.2.1 Quality Conformance Sample. For all items except developer solids, one sample of not less than 1-quart or no more than 1-gallon SHALL be taken from each batch or lot of each material. For each batch or lot of wet developers in the dry condition, a 2-pound sample SHALL be retained, and from each batch or lot of dry developer solids a 1-pound sample SHALL be retained.

2.6.8.3.2.2 Process Control Reference Sample. These samples SHALL also be retained for use as reference or master standards in comparing the performance of the in-use material. The sample size will depend upon the workload, which determines the frequency of process control testing. A suggested sample size for high volume workload systems is 1 to 2- gallons (for all items except developer solids) from each batch or lot of materials. The suggested quantity of wet developers in the dry condition is 2-pounds. A 2-pound sample is recommended for dry developer solid. Each depot and base SHALL be responsible for determining the sample size required for its workload. The reference sample SHALL be large enough to permit the required process control checks during the life of the material and still have a quantity of reference sample to run a comparison check against the new materials when the old solution is finally discarded.

2.6.8.4 Handling and Storage of New Samples. Care SHALL be exercised in obtaining, handling, and storage of the reference samples to prevent contamination or degradation. The containers SHALL be metal or glass since the penetrant oils and solvents attack many plastics. The same restriction applies to the seals or washers in the container lids. The sample containers SHALL be clean, dry, and have tight fitting lids or covers. The devices used for obtaining the sample SHALL NOT contain traces of other batch or lot materials. The samples SHALL be stored in a cool area and not exposed to sunlight, UV-A lamps, or high intensity white lights.

2.6.8.5 Quality Conformance Testing of New Materials. Depots with the appropriate analytical equipment and competent technicians to perform the required tests may test the following properties for compliance with SAE AMS 2644 in accordance with applicable procedures referenced in the material's specification:

- Flash point (penetrants and lipophilic emulsifiers).
- Viscosity (penetrants and emulsifiers).
- Fluorescent brightness (penetrants).
- Thermal stability (penetrants).
- Water tolerance (water washable penetrants and lipophilic emulsifiers).
- Redispersibility (nonaqueous-wet and aqueous suspended developers).
- Fluorescence (developer).
- Removability (penetrant).
- Water content (hydrophilic remover concentrate).

2.6.8.6 Reporting Unsatisfactory Materials.

NOTE

Reporting problems, even relatively minor items, is essential for improvement in the NDI program, the materials specifications, and qualification testing. Information copies of written correspondence concerning unsatisfactory penetrant materials SHALL be furnished to AFRL/RXS, 2179 Twelfth Street, Bldg 651, Rm R59, Wright-Patterson Air Force Base, OH 45433-7718.

Unsatisfactory materials SHALL be reported in accordance with TO 00-35D-54 (Air Force) or AR 735-11-2 (Army). A copy of the quality conformance test report SHALL be included as substantiating data. The Air Force NDI Program Office, aflcmc-ezpt-ndio@us.af.mil, is the focal point collecting material deficiency reports relative to NDI materials. They may be contacted for assistance when preparing a material deficiency report. (For the Navy: Commanding Officer Naval Aviation Maintenance Office, Attn.: NDI PM, Patuxent River, MD 20670;) for the Army: AMCOM Corrosion Protection Office - NDT, RDMR-WDP-A, Bldg. 7631, Redstone Arsenal, AL 35898; DSN 897-0211.

2.6.9 Testing In-Use Materials.

NOTE

Penetrant materials that are provided ready-for-use and do not require mixing to a concentration, and are not recovered, or reused, or both, (such as materials packaged in aerosol containers, closed drums or materials poured into containers for one-time use) are not subject to the in-use penetrant requirements unless the shelf life has been exceeded or if storage temperatures above 120°F are suspected. Expired penetrant materials in closed containers, including aerosols, SHALL be tested every 12 months. Penetrant materials that are suspected to have been exposed to high temperature storage SHALL be tested just prior to use. Depot facilities using these closed systems SHALL develop a method to monitor system performance and appropriate interval as well as gain approval by the Depot NDI Level 3 Manager.

2.6.9.1 Monitoring the System Performance of the Stationary Penetrant Line. In-use materials SHALL be periodically tested to assure they are capable of acceptable performance. Frequency of in-process testing SHALL be based on the guidelines provided in TO 33B-1-2 WP 102 00 and documented in accordance with [Paragraph 1.5](#). Some in-process checks can be performed in the process tanks, while others are more conveniently performed on small samples taken from the tanks.

2.6.9.1.1 Monitoring of Sensitivity and Removability Using the PSM (Starburst) Panel. The PSM is used to monitor the entire process because it can be processed directly in the working tanks along with production parts. In addition, the grit blasted strip will indicate the effectiveness of the removal process steps. One disadvantage is small or gradual changes are not readily noticed. Furthermore, as with cracked chrome panels, the PSM indications deteriorate with handling and repeated use. Also, the PSM panel can retain large amounts of residual penetrant, so careful and thorough cleaning is mandatory. ARMY ONLY- A PSM panel SHALL be processed prior to the start of any FPI (Methods A, B, C or D) in order to identify process variation attributed to operator processing differences, i.e. penetrant removal and/or developer application and etc.

2.6.9.1.2 Use of PSM Panels. When used in depot inspection facilities the PSM panel SHALL be used to verify the penetrant system performance daily IAW TO 33B-1-2, WP 102 00 Table 1. Because the PSM panel is a qualitative indication of the penetrant system performance, the inspector must be able to “discern” a difference in the panels appearance from one test to another; such as increased background fluorescence or decreased flaw indications or brightness of indications.

2.6.9.1.2.1 Reading PSM Starburst Indications. The inspector SHALL examine the starburst crack centers for the number of starburst indications as well as the brightness and size of the indications. For example, if the developer component is malfunctioning, crack centers may still be indicated but they may not be as bright as normal. Photographs of the indications can be useful to aid recognition of substantial change. Furthermore, when using aqueous developers, the developer SHALL provide a uniform coating over the chrome surface. Failure of the aqueous developer to wet the chrome may mean the solution strength is low or the wetting agent has biodegraded. If a performance problem is noted, additional testing is required to determine the cause.

2.6.9.1.2.2 Reading PSM Fluorescent Background. Washability and background fluorescence must also be interpreted. The grit blasted side of the PSM panel is used for this purpose. Some penetrant systems, especially high and ultrahigh sensitivity systems, leave a fluorescent background on the panel’s grit blasted area. Other systems may leave no background. Neither condition is alarming unless it represents a change from the normal system performance. For example, with a hydrophilic remover system, higher than normal background fluorescence might indicate over dilution of the remover, shortened remover dwell times, absence of an effective pre-wash, etc. Lower background fluorescence might indicate failure to dilute the remover, over-extended remover dwell, inadequate developer application, etc. If a problem is noted, additional testing is required to determine the cause.

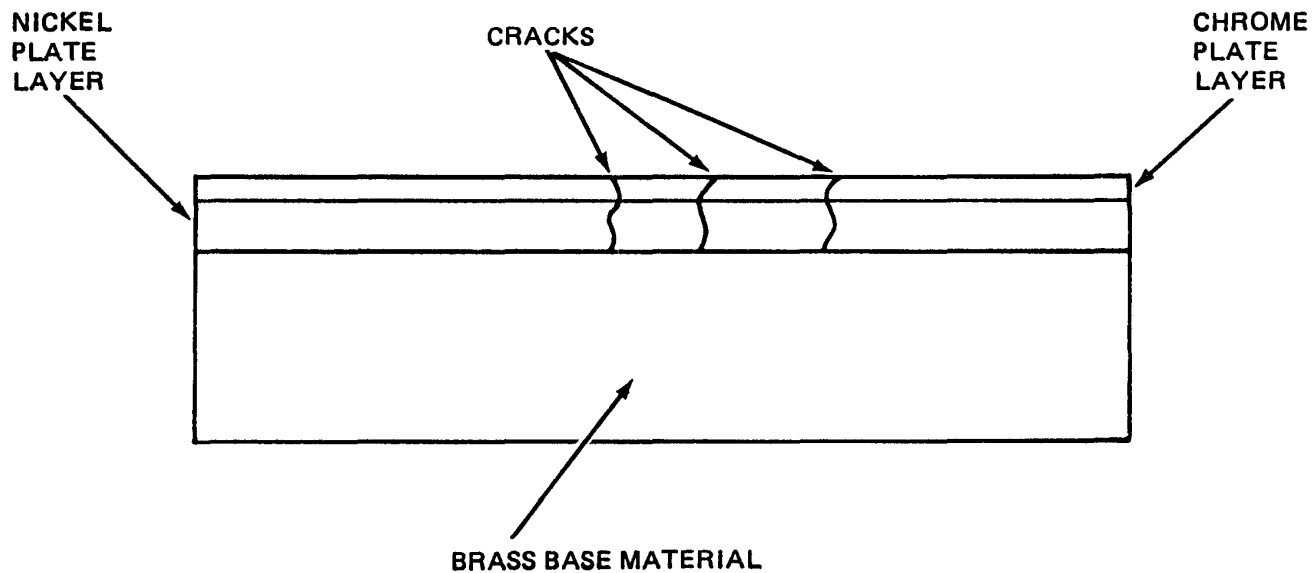
2.6.9.1.2.3 Cleaning PSM Panels. PSM Panels SHALL be thoroughly cleaned prior to use and immediately after use in accordance with procedure published in TO 33B-1-2 WP 102 00.

2.6.9.2 System Performance Test Procedure - Cracked-Chrome Panels.

CAUTION

Use extreme care in handling and storing the panels. Do not drop, hit, or place undue mechanical stress on the test panels. Do not attempt to bend or straighten the test panels. Do not expose the test panels to temperatures above 212°F (100°C). Careful and thorough ultrasonic cleaning of cracked-chrome panels after each use is mandatory. Handle the panels with care. The panels are easily damaged by rough handling or when dropped. Panels indicating or show evidence of damage SHALL be immediately replaced.

The cracked-chrome panel (Figure 2-35) is used for the evaluation of a liquid penetrant system's discontinuity detection performance. They are typically used to provide a qualitative side-by-side comparison of liquid penetrant performance. Their primary advantage is that small or gradual changes are more readily noticed. Generally, tests made with cracked-chrome panels do not provide useful information on the background color or fluorescence caused by surface roughness of test parts or on the ability of a liquid penetrant to reveal micro-cracks in the presence of severe background porosity indications. Furthermore, the chrome plated panel's mirror surface finish and flaw shape are not representative of normal aircraft parts. This requires special procedures when using the test panels. The main difference is the extreme care that SHALL be taken during the surface penetrant removal step. It is very easy to remove entrapped penetrant from the test panel cracks. Panels are cracked on one face only. When the penetrant materials are applied to the cracked face, surplus penetrant materials often get on the back of the panel. Penetrant materials on the back SHALL be removed to keep from contaminating the cracked panel face. Specific procedures for performing this test are located in TO 33B-1-2 WP 102 00.



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Figure 2-35. Illustration of Crack Depth in Cracked-Chrome Panel

2.6.9.3 Storage of Process Control Panels. All process control panels (cracked-chrome panels, PSM panels, gritblast panels) SHALL be stored in a clean environment to retard degradation. The cracked-chrome panels and PSM panels do not have an indefinite life. Penetrant and developer residues plus oxides retained in the cracks will gradually clog or fill the cracks, thus reducing the apparent size of the indications.

2.6.9.4 Additional Testing of Penetrant Material. Additional tests to determine the total working conditions of the penetrant include:

- Surface Wetting Test

- Penetrant Brightness Test
- Concentration of Water Based (Method A) Test
- Lipophilic (Method B) Emulsifier Removability Test
- Hydrophilic Remover Refractometer Test
- Hydrophilic Remover Hydrometer Test
- Hydrophilic Remover Performance Check
- Hydrophilic Remover Background Fluorescence Check
- Hydrophilic Remover Spray Solution Test
- Water-Suspended Developer Concentration Test
- Water-Suspended (or Soluble) Developer Coating Uniformity Test
- Water-Suspended (or Soluble) Developer Penetrant Contamination Test
- Water-Soluble Developer Concentration Test
- Dry Developer Contamination Test

2.6.9.4.1 Completing Intervals and Procedures. The intervals and procedures for completing the tests listed above are published in TO 33B-1-2 WP 102 00.

2.6.9.4.2 Surface Wetting Test. This test ensures the penetrant readily wets the surface and the penetrant film does not retract or form beads.

2.6.9.4.3 Penetrant Brightness Test. This test method compares the in-use penetrant with the reference penetrant. A comparison of the brightness is done between the two samples.

2.6.9.4.4 Testing Concentration of Water Based (Method "A") Penetrants. There are a small number of approved Method "A" penetrants currently containing water as a major constituent. These penetrants have been formulated to provide similar sensitivity performance to penetrants within the same sensitivity level while at the same time providing more environmentally friendly characteristics. Because water is a main constituent and evaporation losses may affect the penetrant performance, a periodic water concentration check is required. The water content of water-based method "A" penetrant shall be checked using a refractometer. The water content must be maintained according to the manufacturer's recommendation.

2.6.9.4.5 Testing Lipophilic Emulsifier (Method "B"). Penetrant is an unavoidable contaminant of lipophilic emulsifier. It is carried into the emulsifier on the surface of parts where it dissolves and is washed off during immersion and drain process. Since emulsifier and penetrant are capable of being mixed in all concentrations, even small quantities of fluorescent dye will cause the emulsifier to fluoresce. The fluorescent brightness increases with increasing dye content, but it is impossible to visually estimate penetrant contamination by observation of the tank surface. Emulsifier will continue to function when contaminated with penetrant; however, when the penetrant concentration reaches a certain level, the emulsification action slows and eventually stops. The penetrant material specification (SAE-AMS-2644) requires a 4-to-1 mixture of emulsifier to penetrant to leave no more residual background than the uncontaminated emulsifier.

2.6.9.4.6 Hydrophilic Remover Bath Concentration Test.

2.6.9.4.6.1 Hydrophilic Remover Immersion Bath Test. Freshly mixed (new) hydrophilic remover is characterized by a pinkish-red color that varies in intensity with the water content. The following three methods are used to verify initial remover concentration.

2.6.9.4.6.1.1 Hydrophilic Remover Refractometry Test.

NOTE

The refractometry test is the preferred method for measuring the concentration of hydrophilic remover baths. Since the refractive index and light transmission properties of removers vary from batch to batch (even with the same type and manufacturer), each NDI lab SHALL verify the value obtained from both with the graph provided by manufacturer showing concentration versus refractive index value reading for each batch or lot of remover when it is prepared.

Refractometry is a test method by which the refractive index (Snell's Law) of a material is measured using a simple device called a refractometer. A refractometer measures the refractive index using the refractive index scale, which ranges from 0 to 320, with water having a refractive index of 0. A refractometer is supplied in the penetrant process control kit and is the recommended method to use in determining the initial water content concentration. Refractometry is also an acceptable method for testing in-use hydrophilic remover concentration provided that penetrant contamination is not excessive. A hydrophilic remover performance check will usually indicate excessive penetrant contamination before the refractive index is affected by penetrant contamination.

2.6.9.4.6.1.1.1 Creating a Hydrophilic Remover Concentration versus Refractive Index Graph. Upon completion of the graph, maintain on hand and use to determine accurate readings from the refractometer when performing your Hydrophilic Remover Refractometer Test.

- a. Using a Graduated Cylinder: Mix a 10% Concentration of Hydrophilic remover to water (Ex. 10 ML Hydrophilic Remover concentrate to 90 ML Water). Mix the concentration within the graduated cylinder thoroughly to ensure consistency of the mixture.
- b. Perform the refractometer test on the mixture and record Refractive Index Value.
- c. Plot the refractometer reading onto your grid using the Y axis as your refractometer reading and the X axis as your samples known solution concentration.
- d. Clean the Graduated Cylinder and make sure it is completely dry and free of any water or left over remover.
- e. Repeat steps a thru d to record your values for 20% and 30% concentrations.
- f. Using a ruler, starting at the zero between the X and Y axis, draw a line through the points plotted on the graph.
- g. Highlighting your allowable range (per manufacturer of emulsifier) makes it easier when performing the hydrophilic refractometer test (shaded area) you can highlight the area by using the line from the plot graph ([Figure 2-36](#)).

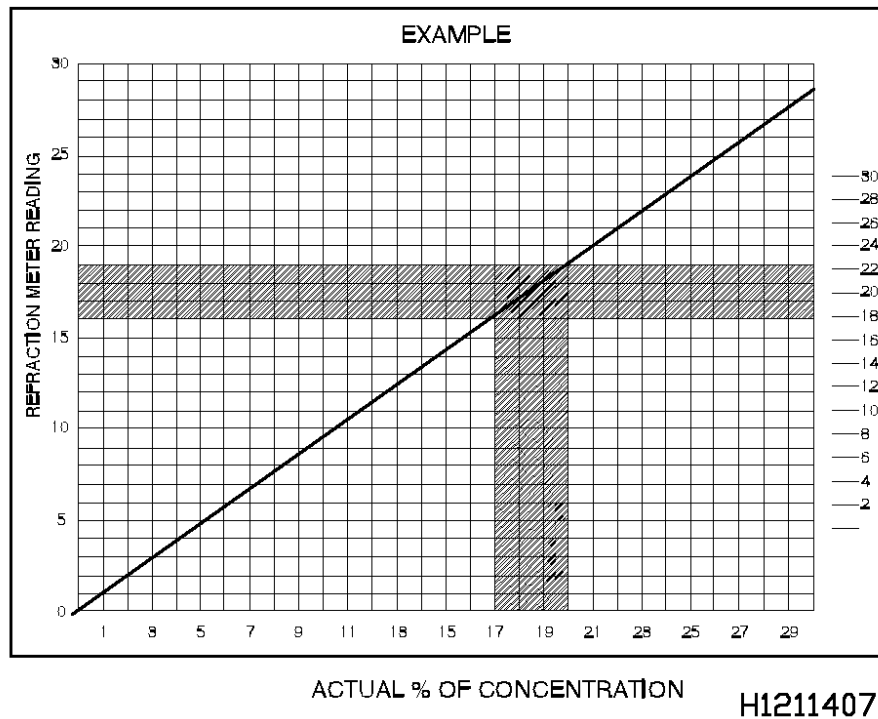


Figure 2-36. Remover Concentration vs Refractive Index Graph

2.6.9.4.6.1.2 Hydrophilic Remover Visual Colorimetry Test.

NOTE

There is no requirement at this time to perform this test.

Visual Colorimetry is an alternate method for measuring the concentration of hydrophilic remover solutions. It is a method which utilizes the measurement of the light absorption by colored solutions. The fundamental principles of visual colorimetry state that the amount of light absorbed by a given substance in a solution is proportional to the intensity of incident light and to the concentration of absorbing material. Colorimetry is a simple method and is fairly precise. It matches the color of a standard solution with an unknown; when they become identical they must contain the same amount of colored substance. The instrument used to perform this task is known as a colorimeter. This method may be performed by depots with the appropriate equipment.

2.6.9.4.6.1.3 Hydrophilic Remover Hydrometry Test.

NOTE

The refractometry method is the preferred method for measuring the concentration of hydrophilic emulsifiers. Hydrometry may be used if recommended by the manufacturer of the hydrophilic remover.

The hydrometry test involves the use of a hydrometer to determine the concentration of a solution by specific gravity.

2.6.9.4.6.2 Testing Water-Suspended Developer.

CAUTION

Prior to using a new solution, a working level SHALL be established by measuring the distance from the top of the tank to the solution itself. This working level SHALL be maintained by the addition of water to replace evaporation losses.

2.6.9.4.6.2.1 Why Test Water-Suspended Developer . There are a number of service factors affecting the performance of water-suspended developers. Most significant of these are changes in concentration and contamination problems.

2.6.9.4.6.2.2 Water-Suspended Developer Concentration Level. Reduced concentration results in thin coatings, which decrease the sensitivity of the system. Developer concentration may vary for a number of reasons:

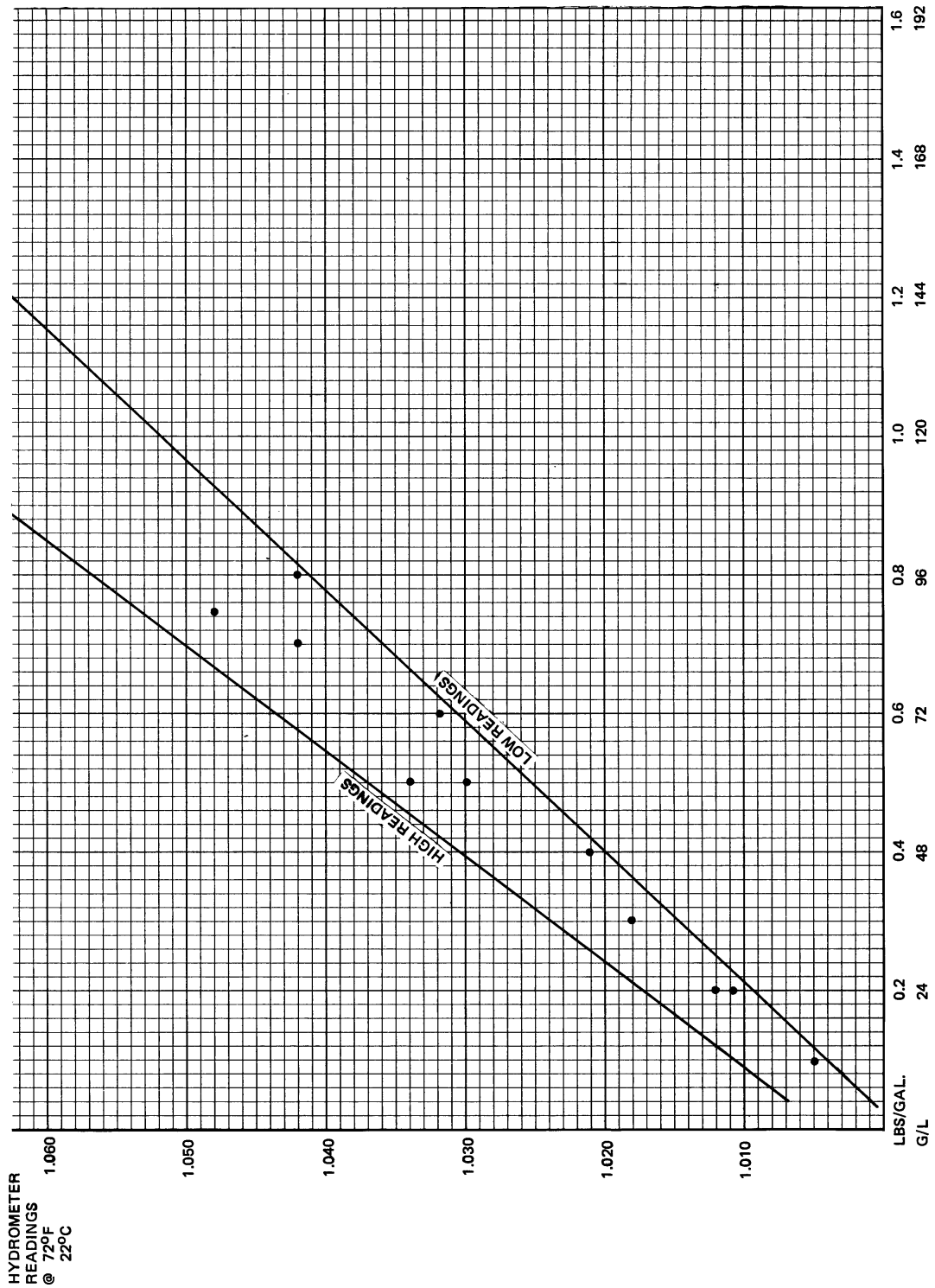
- Evaporation - As water evaporates, the concentration levels increase, causing excessive coating thickness on the part.
- Drag-out - As parts are processed, developer is removed due to the film adhering to the part surface, or entrapped in recesses of the part. This loss of developer is termed drag-out and, unless concentrate is added, will result in reduced developer concentration.
- Inadequate agitation - Allows some of the developer particles to settle out, which also reduces concentration.
- Caking - It is also possible for the developer particles to cake on the bottom or in the corners of the tank preventing them from being suspended.

2.6.9.4.6.2.3 Contamination of Water-Suspended Developer . Developer contamination takes a close second to concentration problems. Fluorescent dye contamination can be caused by the wetting agents inherent in the developer, which can remove penetrant entrapped in the part.

CAUTION

Prior to obtaining the hydrometer reading, the working solution SHALL be filled to the proper working level (as previously measured and marked), thoroughly agitated, and the tank checked for caked particles on the bottom or in the corners. Newly prepared solutions SHALL NOT be used or checked for concentration until 4-hours after mixing. This aging period allows the developer particles to become wetted or saturated. The solution SHALL be stirred after the 4 hour aging period.

2.6.9.4.6.2.4 Water-Suspended Developer Concentration Test. A specific gravity vs. concentration graph SHALL be used when checking the developer concentration. An example of such a specific gravity vs. concentration graph for two water-suspended developers is illustrated in [Figure 2-37](#). This graph illustrates the variation that can occur in the specific gravities of different water-suspended developers, even from the same manufacturer. The reading from the hydrometer is then compared to an accurate graph/conversion chart, which may be obtained from the supplier for the specific developer. This graph/chart SHALL be used when checking the developer concentration, an example is shown in [Figure 2-38](#). A specific gravity vs. concentration graph is needed for each developer since variations can exist between different developers, even when they are made by the same manufacture.



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Figure 2-37. Specific Gravity Hydrometer Readings for Two Water-Suspended Developers

2.6.9.4.6.2.5 Water-Suspended Developer Penetrant Contamination Test. Water-suspended developer may also become contaminated with penetrant. Check for fluorescent penetrant dye contamination via visual examination of the bath surface by passing a UV-A lamp over it. Uncontaminated developer appears dull white while fluorescent dye contamination will show up as specks of yellow-green, floating on the top of the bath. Low-levels of contamination can be skimmed off the developer liquid surface. Baths that exhibit significant amounts of surface penetrant that cannot be completely separated must be replaced.

2.6.9.4.6.2.6 Testing Water-Soluble Developer.

NOTE

Water-soluble developer SHALL NOT be stirred or agitated after its initial mixing or for this test.

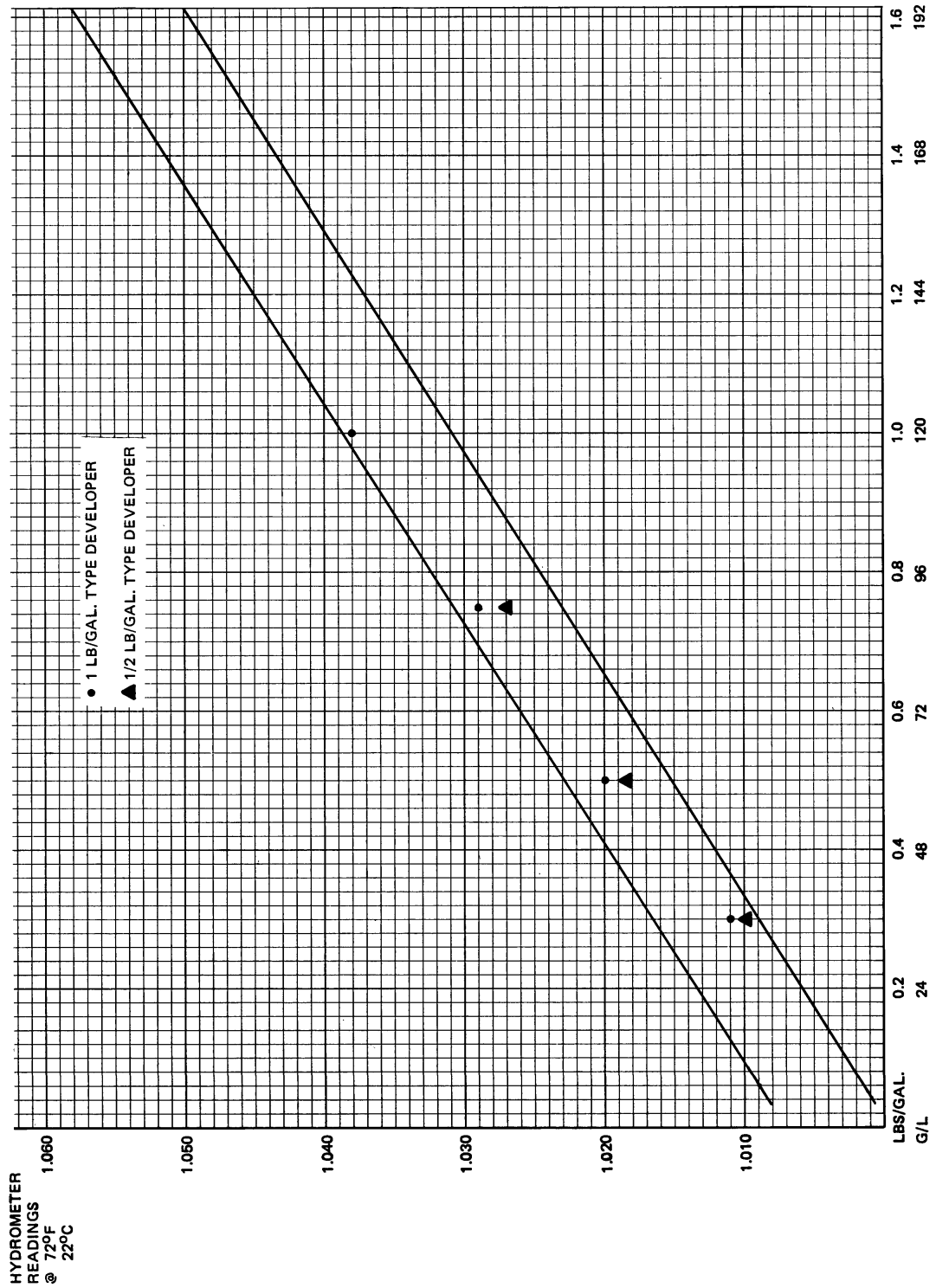
Water-soluble developers reduce the number of in-service problems encountered with suspended developers since agitation is not required and the particles do not settle out. However, there are still concentration and contamination problems to be aware of. As stated with water-suspended developers, evaporation and drag-out still factor in concentration changes, and the wetting agents can still remove entrapped penetrant resulting in contamination. Due to these factors, water-soluble developers SHALL be periodically tested to ensure acceptable performance is maintained.

2.6.9.4.6.2.7 Water-Soluble Developer Concentration Test.

NOTE

There are a wide variety of materials available to formulate water-soluble developers; therefore, the specific gravity hydrometer readings versus concentration will vary more than they will for the water-suspended developers. Generally, the manufacturer's recommended concentration level is used in standard penetrant systems. Poor water quality can cause situations where water-soluble developer does not completely dissolve in the concentration recommended by the manufacturer. Using warm distilled or filtered water may increase the amount of developer dissolved in the solution. Generally, concentrations lower than 0.5 lbs per gallon are not recommended because the solution may not contain enough chemical additives to prevent algae growth or poor wetting qualities.

The concentration range (between the lines) for several water-soluble developers of one manufacturer is shown in [Figure 2-38](#). The supplier can provide an accurate conversion chart for its particular developer, which SHALL be used when checking the developer concentration.



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Figure 2-38. Specific Gravity Hydrometer Readings vs Concentration for One Manufacturer's Water-Soluble Developers

2.6.9.4.6.2.8 Water-Soluble Developer Penetrant Contamination Test. Water-soluble developer may also become contaminated with penetrant. Uncontaminated developer appears dull white while fluorescent dye contamination will show up as specks of yellow-green, floating on the top of the bath. Low-levels of contamination can be skimmed off the developer liquid surface.

2.6.9.4.6.3 Testing Dry Developer.

2.6.9.4.6.3.1 Why Test Dry Developer. Dry developers, unlike water-based developers, do not have problems with concentration changes, however they do become contaminated. This contamination comes from moisture condensation; water from inadequately dried parts or splashed into nearby containers by careless rinsing. Dry developers may also become contaminated by penetrant transported by improperly rinsed parts. This forms lumps of penetrant-soaked developer and may fall off during developer application.

SECTION VII SPECIAL PURPOSE LIQUID PENETRANTS

2.7 SPECIAL PURPOSE LIQUID PENETRANT.

2.7.1 General.

NOTE

The materials described in this section are not covered in QPL SAE AMS 2644. There are a number of penetrant materials that differ from the materials described in the previous sections. These materials are formulated for special applications and purposes. These materials SHALL NOT be used without specific guidance from the responsible engineering authority.

This section describes these special purpose materials and discusses the reasons for their use. The application procedures vary widely between materials and manufacturers; therefore procedures are intentionally not covered. Each of the manufacturers provides detailed application procedures for the particular material when it is procured.

2.7.2 Liquid Oxygen (LOX) Compatible Penetrants. Liquid oxygen (LOX) has a high degree of chemical reactivity. It will explosively react or combine with a large number of materials. This includes traces or residues from normal penetrant inspection materials. There are special cleaning procedures to be used on parts and components that will be contacting gaseous or liquid oxygen. Disassembled parts may be penetrant inspected in the lab, but SHALL be sent to the cleaning shop for complete removal of residual inspection materials. Difficulties are encountered with assembled parts (on or off of aircraft) and complex shaped parts containing crevices, recessed areas, or faying surfaces where inspection materials become trapped and are not easily removed by cleaning. Such items SHALL be inspected using another nondestructive test method, or special penetrant materials SHALL be used which do not react with oxygen. There are LOX compatible materials available by special order. These materials are mainly intended for use on space vehicles and can be used on aircraft when required.

2.7.2.1 Requirements for LOX Compatible Materials. Testing for LOX compatible materials involves dropping a weight on the material in a LOX environment. If the material is not compatible (e.g., will readily burn in an oxygen rich atmosphere), it will cause an audible explosion, a visible flash in a darkened room, discolor the impact surface, or leave evidence of charring. There are two ways of avoiding a LOX reaction from penetrant materials:

- a. Completely remove all conventional inspection material residues. NDI inspectors are not properly trained in these cleaning processes.
- b. Use only materials inert in an oxygen environment. This is not simple, since the penetrant system is specifically formulated to detect very small flaws. These penetrants are designed to resist removal from cracks and crevices and the organic dyes are oxygen reactive.

2.7.2.1.1 Choosing LOX Compatible Penetrants. There are three approaches used in choosing LOX compatible penetrant systems:

- a. Use materials soluble in water and lending themselves to complete removal during post cleaning. These penetrants have dyes and developer materials soluble in water. Water-soluble penetrants, if their water content is high, are LOX insensitive, however, when the water evaporates, the residues can become LOX sensitive. Water-soluble penetrant systems have been approved for some LOX related applications since their residues are water-soluble surface agents similar to detergents. Approval for LOX applications is based on their ease of removal from surfaces and flaw entrapment using plain water.
- b. Use materials that are completely volatile and evaporate from the parts without leaving a residue. These penetrants have a class of dyes that sublimes at room or up to temperatures in the range of 130° to 200°F (54° to 93°C). These and other materials will fluoresce from a discontinuity and will dissipate entirely from the flaw on setting or when the part is slightly heated. The materials have been used in formulating volatile penetrant systems. The problems to be considered are:
 - Even though the materials evaporate from the surface or a flaw, there is still the possibility of it re-depositing at another location.
 - Determination of 100-percent dissipation as judged by the disappearance of an indication does not mean a residual-free surface or crack.
- c. Use non-reactive liquids that maintain the dyes in solution and are completely wetted by the liquid at all times. Another method of formulating penetrants not LOX-reactive is to dissolve the dye in a non-reactive, non-volatile liquid or vehicle. The liquid serves to quench the reactivity of the dye and, since it is non-volatile, does not produce a reactive residue. Water based penetrants do not meet this criteria, since they evaporate, leaving a reactive residue. There are some useful fluorinated hydrocarbon liquids, commonly called fluorocarbon or fluorolube oils that may be employed as penetrants. Fluorolube oils are quite non-volatile and are non-reactive with LOX. They also act to quench any LOX reactivity of dye that is dissolved in or wetted by the fluorolube oil. Unfortunately, they are not good solvents for fluorescent dye.

2.7.3 Low Sulfur, Low Chlorine Penetrant Systems.

NOTE

Low sulfur and low halogen penetrant material requirements are not covered in QPL SAE AMS 2644.

There is considerable concern over the effects of small quantities of sulfur and halogens present in penetrant materials. This concern is due to the increased use of high temperature alloys such as nickel and cobalt-base alloys, austenitic stainless steel, and titanium in aircraft and engines. These alloys are susceptible to hydrogen embrittlement, intergranular corrosion, and stress corrosion. Small amounts of sulfur and halogens, principally chloride, remaining on the alloys during service will increase their susceptibility to attack. Sulfur and halogens are not essential compounds in penetrant materials, nor are they deliberately added. They are usually introduced as contaminants in the raw materials. There is considerable difference of opinion as to the allowable limits of these contaminants. Nuclear and boiler codes specify from 0.5% to 1% by weight as the maximums. Many of the QPL materials will meet at least the upper limit. The position is similar to that for LOX compatible materials, namely, there is no requirement for special penetrants if the part to be inspected is disassembled and can be sent to the cleaning shop for the removal of all inspection residues. The aircraft or engine manufacturer's recommendations SHALL be followed for on-aircraft and assemblies.

2.7.4 High Temperature Penetrant Materials. Standard penetrant materials are limited to temperatures of 125°F (52°C). There are special penetrant systems formulated for use above 125°F (52°C). These special high-temperature penetrants contain visible and fluorescent dyes that resist heat degradation. The vehicles and solvents are carefully chosen to remain liquid and resist evaporation at the operating temperature. The nonaqueous-wet developer must be modified since standard developer will peel or curl on hot surfaces. The upper temperature limits are in the range of 350°F (177°C) to 400°F (204°C). Typical applications for high temperature penetrant systems are the inspection of live steam valves and lines and intermediate weld beads prior to laying down a covering bead.

2.7.5 Dye Precipitation Penetrant Systems.

NOTE

Dye precipitation penetrant systems are not covered by penetrant material specification SAE AMS 2644.

Dye precipitation penetrant systems are commonly referred to as high-resolution penetrants. The penetrant contains a high concentration of either visible or fluorescent dye dissolved in a highly penetrating, volatile solvent. The penetrant is usually applied by brushing on the surface to be inspected. The penetrant will enter any discontinuities, and during the dwell period, the solvent evaporates, precipitating the dye as a solid, which fills the discontinuity. A very thin layer of solvent developer is sprayed onto the surface after removal of the excess surface penetrant and while using a two-step development process. The developer re-dissolves the solid penetrant dye entrapped in the flaw, expands its volume, and extracts it from the flaw. It is possible to build the indication to any desired size and resolution by applying additional thin coats of solvent developer. When the indication reaches the desired size, it is fixed by applying a layer of plastic developer. The plastic developer allows the developer coating with the embedded indication to be removed or stripped from the part. There is also a one-step developer that provides the same result. Dye precipitation penetrant systems are extremely sensitive.

2.7.6 Reversed Fluorescence Method. The reversed fluorescence method is similar to a photographic negative of the standard fluorescent penetrant inspection. A standard visible-dye penetrant is applied to the surface to be inspected and after the dwell; the excess is removed in the normal manner. A special developer, containing a low intensity fluorescing dye and a relatively small amount of developer powder, is applied by spraying under a UV-A lamp. The entire surface will fluoresce, except for the flaw, which appears as a dark line where the penetrant has quenched the fluorescent dye.

2.7.7 Thixotropic Penetrant. A thixotropic material is one that changes form or structure as a function of time or shear stress. Thixotropic penetrants are applied as a solid or gel and then change to a liquid after application. They are used when it is difficult to apply the penetrant as a liquid. One example is a high temperature penetrant in the form of a crayon or stick used to inspect welds before they have cooled.

2.7.8 Dilution Expansion Developers. Dilution expansion developers differ from the conventional powder type developers in they do not utilize the absorption-adsorption action of powder particles. In fact, powder particles are not required and may even interfere with the action of dilution-expansion developers. The action of dilution-expansion developer is to dissolve the exuded and exposed layer of entrapped penetrant and disperse it in the thicker layer of developer. Dilution-expansion developers have a layer thickness equivalent to that of conventional powder developers.

2.7.9 Plastic-Film Developers. Plastic-film developers form a dry, flexible layer that can be peeled or stripped to provide a record of indications on test surfaces. The most frequently used plastic-film developers are two-part systems. The first part provides developer action while forming a white, reflecting background. The second part forms a clear layer that freezes the indication and provides film strength and some flexibility. The layers combine and can be removed from the part as a thin film and maintained as a record of the indication.

SECTION VIII LIQUID PENETRANT INSPECTION SAFETY

2.8 LIQUID PENETRANT INSPECTION SAFETY.

2.8.1 Safety Requirements. Safety requirements SHALL be reviewed by the laboratory supervisor on a continuing basis to ensure compliance with provisions contained in AFMAN 91-203 or appropriate directive as well as provisions of this technical order and applicable weapons systems technical orders. The material safety data sheet (MSDS or SDS) for each penetrant material SHALL be reviewed by the shop supervisor before the material is first put into use. Recommendations of the Base Bioenvironmental Engineer and the manufacturer regarding necessary personnel protective equipment SHALL be followed.

NOTE

AFMAN 91-203 or appropriate service directive SHALL be consulted for additional safety requirements.

2.8.2 General Precautions. Precautions to be exercised when performing penetrant inspection include consideration of ventilation, skin irritation, fire, electrical, and use of UV-A lamps. The following minimum safety requirements SHALL be observed when performing penetrant inspections.

2.8.3 **Personal Protection Equipment.** Penetrants, emulsifiers, and some types of developers have very good wetting and detergent properties, and can act as solvents for fats and oils. If they are allowed to remain in contact with body surfaces for extended periods, they MAY cause skin irritation. Personal protective equipment SHALL be supplied and worn when handling penetrant materials. Wear eye protection, an apron, and gloves while processing parts and changing chemicals.

2.8.3.1 **Protective Gloves.** Neoprene gloves are an excellent choice when handling penetrant materials, and SHOULD be worn unless another suitable substitute is identified and approved by the Base Bioenvironmental Office. The insides of gloves SHALL always be kept clean. Wash exposed areas of body with soap and water, continual contact with penetrant materials MAY cause skin irritation and a removal of natural body oils.

2.8.3.2 **Eye Protection.** Wear eye protection (e.g., goggles, face shield, safety glasses) while using penetrant inspection material. Protect the eyes from all possible hazards associated with the penetrant process. At different stages of the process different eye protection may be required. For ultraviolet light, UV filtering safety glass are sufficient. UV filtering safety goggles or face shields are more appropriate for combination chemical splash and UV protection.

2.8.4 **Ventilation.**

WARNING

Penetrant inspection materials MAY be harmful when vapors are inhaled when exposed to skin for an extended period of time. Proper safeguards and personnel protective equipment (PPE) SHALL be used as recommended by the local Base Bioenvironmental Office and product manufacturer.

CAUTION

Many penetrant materials are combustible, but most have relatively high flash points. They are not considered a serious fire hazard in open tanks, however, when sprayed as a fine mist, they are easy to ignite and open ignition sources SHALL be avoided when spraying is used.

Some penetrant materials contain volatile solvents that can be nauseating. This is especially true of the vehicles in aerosol or pressure spray containers. Provide adequate ventilation when penetrant inspection is being performed. When recommended by the base bioenvironmental engineer, wear an approved respirator working in areas where adequate ventilation cannot practically be provided. Dry developer materials are a fine dust. A protective device SHALL be worn over the nose and mouth during this process.

2.8.5 **Matting.** Use rubber insulating floor matting in front of penetrant lines. This matting is required to reduce electrical and slipping hazards. This matting SHALL be replaced when it is worn to one-half the original thickness (approximately 1/8-inch). Use only one continuous length of matting and ensure it continues beyond the ends of the equipment for at least 24-inches. If facility construction or safety walkways prevent extension beyond equipment, local safety office may approve deviation IAW AFMAN 91-203 or appropriate service directive.

2.8.6 **UV-A Hazards.**

WARNING

Unfiltered ultraviolet radiation can be harmful to the eyes and skin. UV-A lamps SHALL NOT be operated without filters. Cracked, chipped, or ill-fitting filters SHALL be replaced before using the lamp.

Prolonged direct exposure of hands to the filtered UV-A lamp main beam MAY be harmful. Suitable gloves SHALL be worn, during inspections, when exposing hands to the main beam for extended periods.

- The temperature of some operating UV-A lamp bulbs reaches 750°F (399°C) or more during operation. This is above the ignition or flash point of fuel vapors. These vapors will burst into flame if they contact the bulb. UV-A lamps SHALL NOT be operated when flammable vapors are present.

- Exercise care when using hot mercury vapor or gas discharge lamps so as to not burn hands, arms, face, or other exposed body areas. Do not lay hot UV-A lamps on combustible surfaces. The bulb temperature also heats the external surfaces of the lamp housing. The temperature is not high enough to be visually apparent, but is high enough to cause severe burns with even momentary contact of exposed body surfaces. Extreme care **SHALL** be exercised to prevent contacting the housing with any part of the body. Consult your local bioenvironmental office for specific guidance.
- Ensure workers do not handle UV-A lamps at the penetrant rinse station when washing parts, because of electrical hazard present.
- UV-A filtering safety glasses are specifically designed for penetrant and magnetic particle inspections and are recommended as they will filter out glare and reduce eyestrain. Install ultraviolet filters on all mercury vapor lamps used for penetrant inspection. Replace cracked, chipped, or broken filters before using the light. Injury to eyes and skin will occur if the light from the mercury vapor bulbs is not filtered. UV-A filtering safety glasses, goggles, or face shields **SHALL** be worn and precautions **SHALL** be taken to cover exposed skin that is exposed to the direct beam of any UV-A lamp.

2.8.7 Hazards of Aerosol Cans. Aerosol cans are a convenient method of packaging a wide variety of materials. Their wide use, both in industry and the home, has led to complacency and mishandling.

2.8.7.1 Aerosol cans are gas pressured vessels, when heated to temperatures above 120°F (49°C) the resulting gas pressure may potentially burst the container. Any combustible material, regardless of flash point, can ignite with explosive force when it is finely divided and dispersed in air. Penetrant materials **SHALL** be stored in a cool dry area, protected from direct sunlight.

2.8.7.2 Penetrant materials (penetrant, cleaner/remover and developer) **MAY** contain petroleum distillates and aliphatic (kerosene, mineral spirits, etc.) or aromatic (benzene type hydrocarbon) solvents. These chemicals **SHALL** be carefully used in the aerosol form to avoid health hazards.

CHAPTER 3

MAGNETIC PARTICLE INSPECTION METHOD

SECTION I MAGNETIC PARTICLE (MT) INSPECTION METHOD

3.1 GENERAL CAPABILITIES OF MAGNETIC PARTICLE INSPECTION.

NOTE

The terms MPI, MPT, and MT are used interchangeably in this chapter.

3.1.1 Introduction to Magnetic Particle Inspection (MPI). Magnetic particle inspection is an NDT method used to reveal surface and near surface discontinuities in magnetic materials. This inspection method can only be used on materials that can be magnetized (known as ferrous). The MPI process, when properly performed, establishes a field leakage site on the surface of the part below which the flaw lies. This chapter presents theory and practical guidance for the performance of magnetic particle inspection. Process control and basic inspection procedures are located in TO 33B-1-2.

3.1.2 Benefit of Magnetic Particle Inspection. MPI is the method of choice on ferrous materials instead of liquid penetrant because it is faster, requires less surface preparation, and in some instances is able to locate subsurface flaws.

3.1.3 Basic Concept of Magnetic Particle Inspection. MPI relies on the principle of magnetism ([Paragraph 3.2.1](#)). Very small ferrous particles, which are suspended in a bath of oil or water, are attracted to magnetic field leakage sites, just as iron filings are attracted to the poles of a magnet. Cracks and similar types of discontinuities cause disruptions in the magnetic field of magnetized parts, in turn attracting these ferrous particles to the leakage site. This allows the inspector to visualize where the discontinuities are located in the part. The keys to a successful magnetic particle inspection are the correct amount of magnetization of the part, in an optimum direction with respect to flaws, and adequate contrast between the part's surface and the particles used to identify the flaw. The particles used are precipitated soft iron, and are stained or dyed in various colors, usually with a fluorescent dye or a red dye. Fluorescent dyes on particles in a liquid suspension are used to find very tight surface flaws. Visible dyes on dry particles are less sensitive to tiny surface defects, but are better for finding subsurface flaws. The type of flaw and/or the inspection environment determines selection of the color or type of particles.

3.1.3.1 The following paragraphs describe in detail the standard terminology used, the theory of magnetism, MPI magnetization and demagnetization techniques, process controls, and safety concerns.

SECTION II MAGNETIC PARTICLE PRINCIPLES AND THEORY

3.2 PRINCIPLES AND THEORY OF MAGNETIC PARTICLE INSPECTION.

3.2.1 Principles of Magnetization. When parts made of ferrous materials, such as iron, are placed in a strong magnetic field or have electric current flowing through them, they will become "magnetized." The degree of magnetization is affected by the strength of the magnetizing field or the amount of current flow. How strongly the ferrous part will be magnetized after the magnetizing force is removed is called "retentivity." Permanent magnets have high retentivity and conductors normally have low retentivity. When a surface or near-surface discontinuity interrupts the magnetic field in a magnetized part, some of the field is forced into the air above the discontinuity resulting in a leakage field. The size and strength of the leakage field depends on the size and proximity of the discontinuity to the magnetic field. The discontinuity is detected by the use of finely divided iron particles applied to a part's surface and attracted to the leakage field. This collection of particles indicates the presence and location of the discontinuity.

3.2.2 Basic Terminology. The following terms and definitions are basic to an understanding of the MPI method.

NOTE

Letters in parentheses refer to the hysteresis curve ([Figure 3-17](#)).

3.2.2.1 Coercive Force. The negative or reverse applied magnetizing force (H) necessary to reduce the residual magnetizing force (B) to zero in a ferromagnetic material, after magnetic saturation has been achieved. The line (O/G) represents the magnitude and direction of this force.

3.2.2.2 Direct Contact Magnetization. Use of current passed through the part via contact heads or prods to produce a magnetic field.

3.2.2.3 Ferromagnetic. A term that describes a material which exhibits both magnetic hysteresis and saturation, also whose magnetic permeability is dependent on the magnetizing force present. In magnetic particle testing, we are concerned only with ferromagnetic materials.

3.2.2.4 Circular Magnetic Field. A circular magnetic field is a magnetic field surrounding the flow of the electric current. For magnetic particle testing, this refers to current flow in a central conductor or the part itself.

3.2.2.5 Longitudinal Magnetic Field. A longitudinal magnetic field is a magnetic field wherein the flux lines transverse the component in a direction essentially parallel with its longitudinal axis.

3.2.2.6 Magnetic Field. The term used to describe the volume within and surrounding either a magnetized part or a current-carrying conductor wherein a magnetic force is exerted.

3.2.2.7 Magnetic Leakage Field. The magnetic field outside of a part resulting from the presence of a discontinuity, a change in magnetic permeability, or a change in the part's cross-section.

3.2.2.8 Magnetic Flux Density (B). The strength of a magnetic field is expressed in flux lines per unit cross-sectional area.

3.2.2.9 Flux Lines or Lines of Force. A conceptual representation of magnetic flux illustrated by the line pattern produced when iron filings are sprinkled on paper laid over a permanent magnet.

3.2.2.10 Magnetic Hysteresis. The phenomenon exhibited by a magnetic system wherein its state is influenced by its previous history.

3.2.2.11 Induced Current Magnetization. Use of an externally applied magnetic field to induce current in a part to produce a magnetic field having the flux direction needed for the inspection. Useful for parts where flowing current directly through the part would risk damaging the part.

3.2.2.12 Magnetizing Current (I). The electric current passed through or adjacent to an object that produces a magnetic field in the object.

3.2.2.13 Magnetizing Force (H). The magnetizing field applied to a ferromagnetic material to induce magnetization.

3.2.2.14 Magnetic Permeability (μ). Magnetic permeability is the ease with which a ferromagnetic part can be magnetized. It is equal to the ratio of the flux density (B) produced to the magnetizing force (H) inducing the magnetic field. It changes in value with changes in the strength of the magnetizing force. A metal easy to magnetize, such as soft iron or low carbon steel, has a high permeability or is said to be highly permeable.

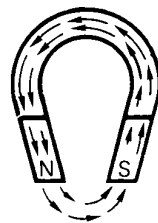
3.2.2.15 Residual Magnetism. This is the magnetic field that remains in the part when the external magnetizing force has been reduced to zero.

3.2.2.16 Retentivity. The property of a metal that remains magnetized after the magnetizing force has been removed. A metal, such as hard steel has a high percentage of carbon, and will retain a strong magnetic field after removal of the magnetizing current. Hard steel has high retentivity, or is said to be highly retentive.

3.2.2.17 Magnetic Saturation. This is the level of magnetism in a ferromagnetic material where the magnetic permeability is equal to one. This is characterized as that level where an increasing in magnetizing force (H) results in no greater increase in magnetic field (B) than would occur in a vacuum or air.

3.2.3 Magnetic Field Characteristics.

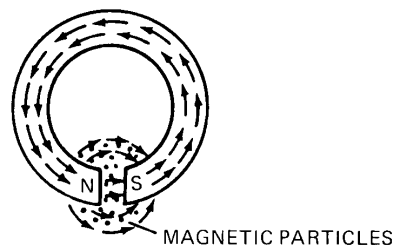
3.2.3.1 Horseshoe Magnet. A familiar type of magnet is the horseshoe magnet ([Figure 3-1](#)). Like a bar magnet, this is a permanent magnet and possesses residual magnetism. It will attract iron filings to its ends where a leakage field occurs. By convention, these ends are commonly called "north" and "south" poles, indicated by N and S on the diagram. Continuous magnetic flux lines, or lines of force in leakage fields, flow from the north to the south pole. In an ideal horseshoe magnet, the flux lines leave only at the poles and consequently an external magnetic force capable of attracting magnetic materials exists only at the poles. This action provides an example of a longitudinal magnetic field. In a real horseshoe magnet very small discontinuities are distributed throughout creating small, weak, localized leakage fields distributed over the surface of the magnet.



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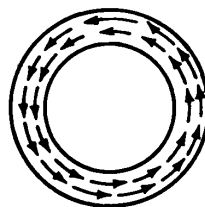
Figure 3-1. Horseshoe Magnet

3.2.3.1.1 If the shape of an ideal horseshoe magnet is changed ([Figure 3-2](#)), the ends will still attract iron filings. However, if the ends of the magnet are fused or welded into a continuous ring as shown ([Figure 3-3](#)), the magnet will no longer attract or hold exterior magnetic materials. This is because the north and south poles no longer exist; thus a leakage field does not exist. The magnetic field will remain as shown by the arrows, but no iron filings are attracted.



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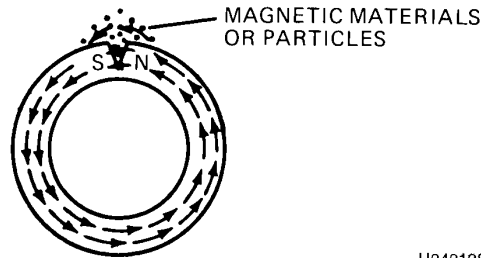
Figure 3-2. Horseshoe Magnet With Poles Close Together



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Figure 3-3. Horseshoe Magnet Fused Into a Ring

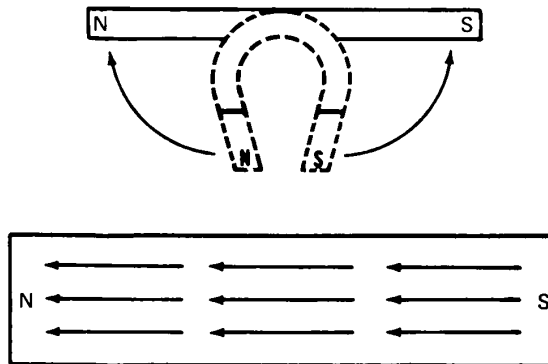
3.2.3.1.2 A transverse crack in the fused magnet or circularly magnetized part (Figure 3-4) will create a leakage field with north and south poles on either side of the crack. Some of the magnetic flux (lines of force) will exit the metal and form a leakage field. The leakage field created by the crack, forming an indication of the discontinuity in the metal part, will attract ferrous particles. This is the principle whereby magnetic particle indications are formed.



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Figure 3-4. Crack in Fused Horseshoe Magnet

3.2.3.2 Bar Magnet. If a horseshoe magnet is straightened, a bar magnet is created (Figure 3-5). The bar magnet has poles at either end and the magnetic lines of force flow through the length, returning around the outside. Magnetic particles SHOULD be attracted only to the poles (in the ideal case). Such a part is said to have a longitudinal field, or is longitudinally magnetized.



H0401986

Figure 3-5. Horseshoe Magnet Straightened to Form a Bar Magnet

3.2.3.2.1 A transverse slot or discontinuity in the bar magnet that crosses the magnetic flux lines will create north and south poles on either side of the discontinuity (Figure 3-6). The resulting leakage field will attract magnetic particles. In a similar manner, a crack, even though it is very fine, will create magnetic poles as indicated in Figure 3-7. These poles will also produce a leakage field that can attract magnetic particles. The strength of the leakage field will be a function of the number of flux lines (e.g., the strength of the internal field), the depth of the crack, and the width of the air gap at the surface. The strength of this leakage field, in part, determines the number of magnetic particles gathered to form indications. Clear indications are found at strong leakage fields, while weak indications are formed at weak leakage fields.

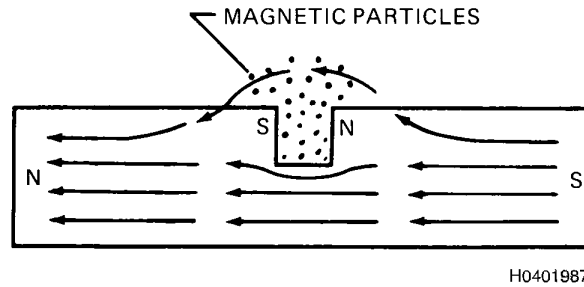


Figure 3-6. Slot (Keyway) in Bar Magnet Attracting Magnetic Particles

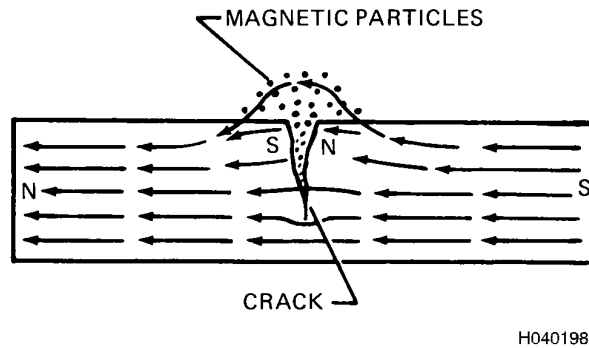


Figure 3-7. Crack in Bar Magnet Attracting Magnetic Particles

3.2.3.3 **Electricity and Magnetism.** Electric current can be used to create or induce magnetic fields in parts made of ferromagnetic materials. Magnetic lines of force are always aligned at right angles (90°) to the direction of electric current flow. It is possible to control the direction of the magnetic field by controlling the direction of the magnetizing current. This makes it possible to induce magnetic lines of force so they intercept defects at right angles.

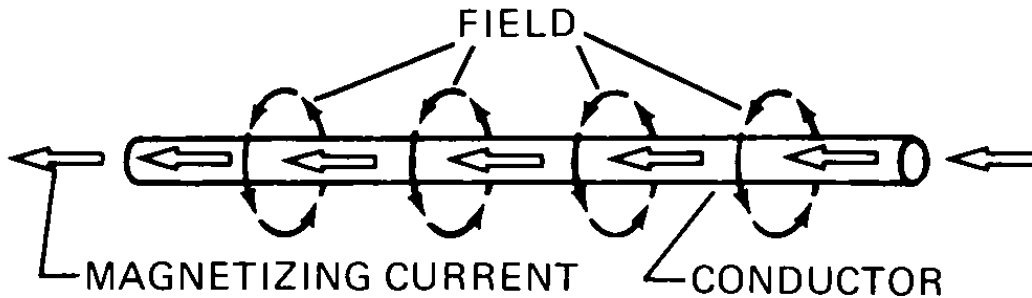
3.2.3.4 **Magnetic Attraction.** Magnetic attraction can be explained by using the concept of flux lines or lines of force. Each flux line forms a closed continuous loop, which is never broken. For a circularly magnetized object, the flux lines are wholly contained in the object (ideal case). No external magnetic poles are present and therefore there is no attraction for other ferromagnetic objects. For a longitudinally magnetized object, the flux lines leave and enter at magnetic poles. They always seek the path of least resistance (e.g., maximum permeability and minimum distance). When a piece of soft iron is placed in a magnetic field it will develop magnetic poles. These poles will be attracted to the poles of the magnetic object that created the initial field. As it approaches closer to the source of the original field, more flux lines will flow through the piece of iron, thus creating stronger magnetic poles and further increasing the attraction. This concentrates the lines of flux into the easily traversed high permeability (iron path) rather than the alternative low permeability (air paths). This is magnetic attraction and is the reason magnetic particles concentrate at leakage fields. The leakage field is established across an air gap of relatively low permeability at the discontinuity. Since they offer a higher permeability path for the flux lines, the magnetic particles are drawn to the discontinuity and bridge the air gap to the extent possible.

3.2.3.5 **Effects of Flux Direction.** The magnetic field must be in a favorable direction, with respect to a discontinuity, to produce an indication. When the flux lines are parallel to a linear discontinuity, the indications formed will be weak. The best results are obtained when the flux lines are perpendicular (at right angles) to the discontinuity.

NOTE

When an electrical current is used for magnetizing, the best indications are produced when the path of the magnetizing current is parallel to and in-line with the discontinuity.

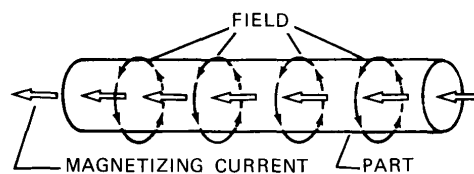
3.2.3.6 Circular Magnetization. A circular magnetic field always surrounds a current carrying conductor, such as a wire or a bar (Figure 3-8). The direction of the magnetic lines of force (magnetic field) is always at right angles to the direction of the magnetizing current. Field orientation and magnitude are based on the direction and amount of current flow.



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Figure 3-8. Magnetic Field Surrounding an Electrical Conductor

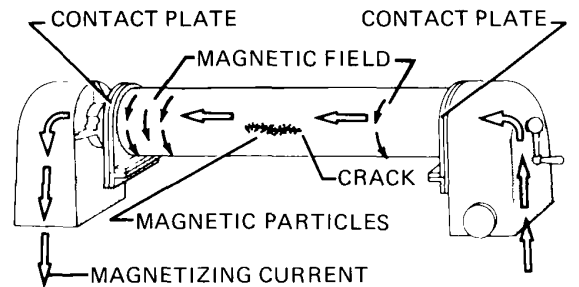
3.2.3.6.1 Since metals are conductors of electricity, an electric current passing through a metallic part creates a magnetic field (Figure 3-9). The magnetic lines of force are at right angles to the direction of the current. This type of magnetization is called circular magnetization because the lines of force, which represent the direction of the magnetic field, are circular within the part.



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Figure 3-9. Magnetic Field in a Part Used as a Conductor

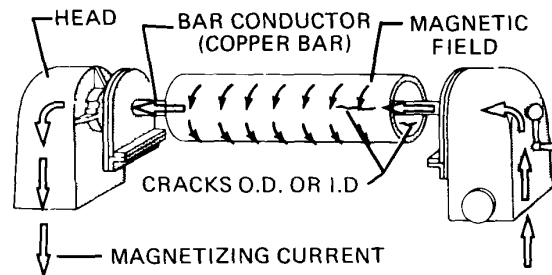
3.2.3.6.2 Circular Magnetization with Inspection Equipment. One method of creating or inducing a circular field within a part with stationary MPI equipment is to clamp the part between two contact plates and pass current through the part as indicated in Figure 3-10. If a longitudinally aligned crack or discontinuity exists within the part, a leakage field will be established at the site of each crack or discontinuity. The leakage field will attract magnetic particles to form an indication of the discontinuity.



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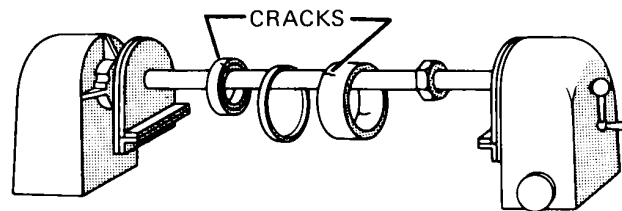
Figure 3-10. Creating a Circular Magnetic Field in a Part

3.2.3.6.2.1 For hollow or tube-like parts, it is often important to inspect both the inside and outside surfaces. When such parts are circularly magnetized by passing the magnetizing current through the part ends, the magnetic field on the inside surface is smaller and opposite than what is produced on the outside surface. To produce a stronger magnetic field on both the inner, and outer surface of the part, a separate conductor, such as a copper rod, is positioned inside the hollow part (see [Figure 3-11](#) and [Figure 3-12](#)). Since a circular magnetic field surrounds such conductors when an electric current is passed through them, it is possible to induce a satisfactory magnetic field on the inside surface and depending on the thickness of the part, the outside surface as well.



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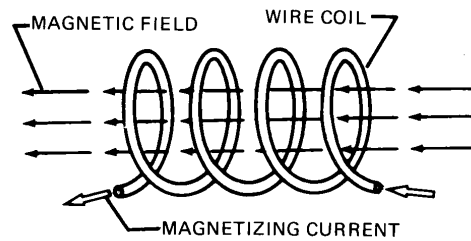
Figure 3-11. Using a Central Conductor to Circularly Magnetize a Cylinder



H0401993

Figure 3-12. Using a Central Bar Conductor to Circularly Magnetize Ring-Like Parts

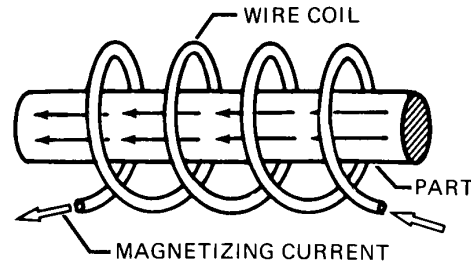
3.2.3.7 Longitudinal Magnetization. Electric current can also be used to create a longitudinal magnetic field in a test part with a current carrying encircling coil. Based on the perpendicular direction of magnetism to current direction, any segment of a coiled conductor will show the field within the coil consists of contributions from each turn of the coil and is aligned lengthwise as indicated ([Figure 3-13](#)).



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Figure 3-13. Magnetic Lines of Force (Magnetic Field) in a Coil

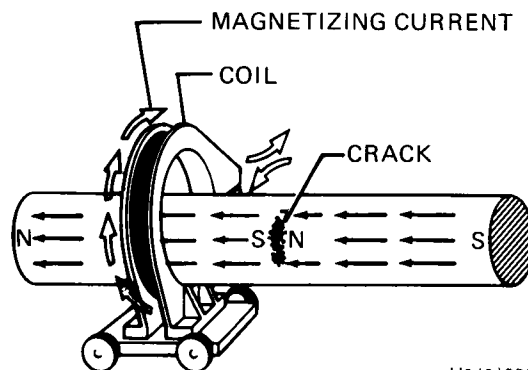
3.2.3.7.1 If a part is placed inside a coil (Figure 3-14), the magnetic lines of force created by the coil are aligned along the longitudinal axis of the coil. If the part is ferromagnetic, the high permeability concentrates the lines of flux within the part and induces a strong longitudinal magnetic field.



H0401995

Figure 3-14. Longitudinal Magnetic Field Produced in a Part Placed in a Coil

3.2.3.7.2 Longitudinal Magnetization with Inspection Equipment. Inspection of a solid bar part using longitudinal magnetization is shown (Figure 3-15). When a transverse discontinuity exists in the part, as in the illustration, a magnetic leakage field is formed at the crack location. This attracts magnetic particles, forming an MPI indication of the transverse discontinuity. Compare Figure 3-15 with Figure 3-10, and note in both cases, a magnetic field has been induced in the part at right angles to the defect. This is the most desirable condition for reliable inspection.

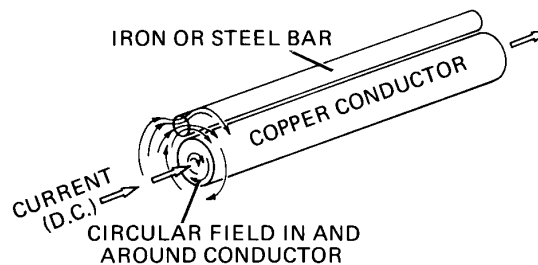


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Figure 3-15. Longitudinal Field Produced by the Coil Generates an Indication of Crack in Part

3.2.3.8 **Multi-Directional Magnetic Field.** Two separate fields, having different directions, cannot exist in a part at the same time. However, two or more fields in different directions can be imposed upon a part sequentially in rapid succession. When this is done, magnetic particle indications can be formed when discontinuities are located favorably with respect to the directions of any of the applied fields, and will persist as long as the rapid alternations of field direction continue. Indications can only be formed if the part is pre-wetted with magnetic particles. This enables the detection of defects oriented in any direction in one operation. The indications must be viewed when the fields are being applied because they are weakly held after the current is discontinued and can be easily dislodged.

3.2.3.9 **Parallel Current Induced Magnetic Field.** If a ferromagnetic bar is placed alongside, and parallel to, a conductor carrying current, a magnetic field will be set up in the bar more transverse than circular (Figure 3-16). Such a field is of very little use for magnetic particle testing. Operators have tried to use this method as a substitute for a headshot for the purpose of producing circular magnetization, but the field produced is not circular and is extremely limited in the transverse direction when inspecting for defects such as seams. Furthermore, the external field around the conductor and the bar can attract magnetic particles and produce confusing backgrounds.



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Figure 3-16. Field Produced in a Bar by a "Parallel" Current

3.2.4 **Currents Used to Generate Magnetic Fields.** There are several types of current used in MPI. These are Straight Direct Current (DC), Single-Phase Alternating Current (AC), Three-Phase AC Current, Half-Wave Rectified Alternating Current (HWRAC or HWDC), Full-Wave Rectified AC Current, and Three-Phase Full-Wave Rectified AC Current (commonly known as DC). Of these, three types of magnetizing current are most often used in magnetic particle inspection. Only one type of current is best suited for each type of inspection to be performed. Alternating current (AC) is preferred for the detection of surface discontinuities. Direct current (DC), full-wave direct current (FWDC), or half-wave direct current (HWDC) can be used for both surface and subsurface discontinuities. Detail on each current follows:

NOTE

Labs using stationary equipment that has multi-DC position selector switches (e.g., HWDC/FWDC) on the operator's control panel SHALL use full-wave direct current (FWDC) for DC magnetization unless otherwise specified in the specific part procedure.

3.2.4.1 **Alternating Current (AC).** Alternating current, which is single phase when used directly for magnetizing purposes, is taken from commercial power lines, or portable power sources, and can be 50 or 60-hertz. Magnetizing currents up to several thousand amperes are used, derived from step-down transformers connected to common line voltages (e.g., 115, 230, or 460-volts).

3.2.4.2 **Direct Current (DC).** Rectified alternating current is by far the most satisfactory source of direct current. By the use of rectifiers, commercially available single and three-phase AC can be converted to a unidirectional current. Rectified three-phase AC is equivalent to straight DC, but exhibits a slight ripple.

3.2.4.3 **Half-Wave Rectified Single-Phase Alternating Current.** Half-wave rectified single-phase Alternating Current, also called Half-Wave Direct Current (HWDC), results in a pattern of unidirectional current flow made up of positive half cycles of the original AC waveform. The negative (reverse) half of each cycle is completely blocked out resulting in a pulsat-

ing unidirectional current. That is, the current rises from zero to a maximum and drops back to zero (replicating the AC's half cycle). This is blocked during the reverse cycle (no current flows), and then repeats the first half cycle.

3.2.4.4 Full Wave Rectified Single-Phase Alternating Current. This pulsating unidirectional current is sometimes used in MPI for certain special purpose applications. In general, however, it possesses no advantage over single-phase half-wave rectified waveforms. Because of its extreme "ripple," it is not as satisfactory as rectified three-phase current when DC is required. It is also more costly since it draws a higher average current from the AC line than does rectified half-wave AC for a given magnetizing strength.

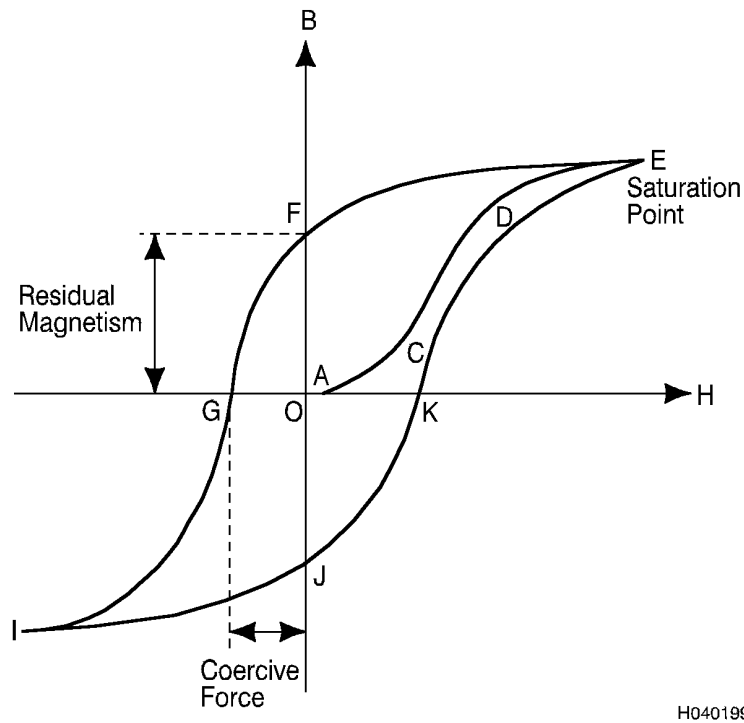
3.2.4.5 Induced Current. When direct current in a circuit is instantly cut off, the field surrounding the conductor collapses, or falls rapidly to zero. If an electrically conductive ferromagnetic material is present in such a field, the collapse of that field will induce a current in the material the same direction as present in the neighboring conductor before cut-off. This phenomenon can be used to solve specific magnetizing problems that have no other practical solution. A useful application of the collapsing field technique has been found in the inspection of ring-shaped parts, such as bearing races, without the need to make direct contact with the surface of the part. Regardless of the type of magnetizing current employed, whether AC, DC, or half-wave, the induced current technique is usually faster and more satisfactory than the contact method. Only one operation is required, and the possibility of damaging the part due to arcing is completely eliminated since no external contacts are made on the part.

3.2.5 Ferromagnetic Material Characteristics.

NOTE

Refer to the hysteresis curve for the letters in parentheses ([Figure 3-17](#)).

All ferromagnetic materials, after having been magnetized, will retain some residual magnetic field. The strength and direction of the residual field depends upon all the magnetizing forces applied since the material was last demagnetized, and the retentivity of the material. The manner in which ferromagnetic materials respond to magnetizing forces is most often portrayed in a plot of the flux density (B) as a function of the magnetizing force (H). The flux density (B) is the number of magnetic lines of flux formed per cross-sectional area as a result of the magnetizing force (H). For an encircling coil, the magnetizing force is the accumulative effect of each turn of the coil and the current passing through it. Therefore, (H) is proportional to the current passing through the coil, multiplied by the number of turns in the coil. A typical (B/H) curve for a ferromagnetic material starting in a demagnetized condition and then cycled to saturation in two opposite directions is shown ([Figure 3-17](#)).



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Figure 3-17. Hysteresis Curve for a Ferromagnetic Material

3.2.5.1 Hysteresis Curve.

NOTE

Refer to the hysteresis curve for the letters in parentheses ([Figure 3-17](#)).

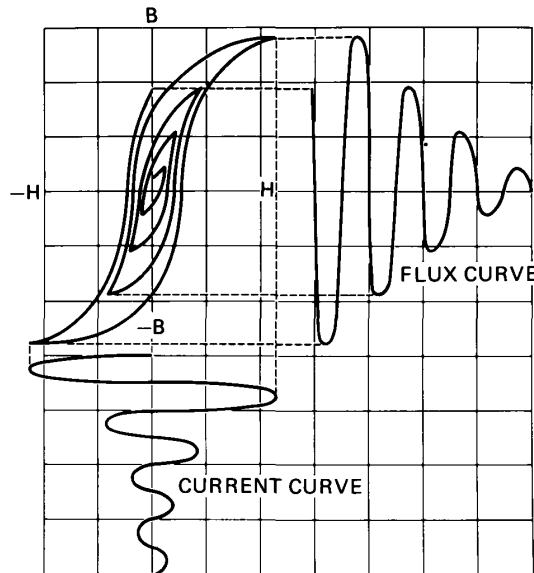
The magnetic field within an unmagnetized piece of steel is zero. As the magnetizing force (H) is increased from zero, the flux density (B) within the part will also increase from zero. The curve from points (A/E) illustrates this behavior. In the region of point (E), the flux density increases up to a point and then tends to level off; this condition is called magnetic saturation and for a magnetically saturated ferromagnetic material the relative permeability (μ) is approximately equal to one. When the magnetizing force is reduced to zero, the flux density does not return to zero. Instead, the flux density returns to a value shown at point (F). This is the amount of residual magnetism resulting from the applied magnetizing force (H) that reached point (E) in the hysteresis curve. As the magnetizing force (H) is increased from zero in the opposite direction, the flux density (B) will decrease to zero, as shown at point (G), and then start to increase to point (I). The magnetizing force (H) represented by the distance (O/G) on the (H) axis is called the coercive force. It represents the strength of the magnetizing force (H) required to reduce the flux density (B) to zero in a saturated ferromagnetic material. A further increase in the magnetizing force (H) to the point (I) results in saturation of the material in a direction opposite to that represented by point (E). Reduction of the magnetizing force (H) to zero from point (I) will reduce the flux density (B) to the value represented by point (J). Application of a magnetizing force (H) in the original direction will change the flux density (B) as shown in the portion (J/K) of the hysteresis curve. Increasing the magnetizing force (H) sufficiently will return the material to saturation as illustrated at point (E).

3.2.5.2 Magnetic Domains in Ferromagnetic Material. The behavior of ferromagnetic materials resulting in properties evidenced by hysteresis curves can be explained in terms of magnetic domains. Domains are small regions within a ferromagnetic material that have a permanent magnetic flux density (B) not equal to zero. In a completely demagnetized ferromagnetic material, the domains are randomly oriented resulting in an overall flux density of zero. When saturated, the domains are all aligned in the direction of the applied field. When the applied field is removed, after saturation, some domains return to their previous orientation, but most remain aligned in the direction of the previously applied field. This results in the residual magnetism observed in ferromagnetic materials. The magnetic behavior then is a result of behavior of the domains within

the ferromagnetic material. Magnetization is the alignment of domains in a single direction; demagnetization is a random arrangement of the domains resulting in a zero net residual magnetism.

3.2.5.3 Demagnetization of Ferromagnetic Material. All parts SHOULD be demagnetized after MPI. Demagnetization may be easy or difficult depending on the type of material, part geometry, and magnetic field orientations used. Demagnetization involves subjecting a magnetized part to a continuously reversing magnetic field that gradually decreases in strength. This action reduces the strength of the residual magnetic field in the part. Although some residual magnetization will remain, this method can reduce the residual magnetic field to acceptable levels.

3.2.5.3.1 There are a number of methods of demagnetization available with varying degrees of effectiveness and they can be explained with the hysteresis curve shown in [Figure 3-17](#). Nearly all are based on the principle of subjecting a part to a continually reversing magnetic field that gradually reduces in strength down to zero. This principle is illustrated in [Figure 3-18](#). The waveform is shown at the bottom of the graph of the reversing current used to generate the hysteresis loops. As the current diminishes in value with each reversal, the loop shrinks and traces a smaller and smaller path.



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Figure 3-18. Flux Waveform During Demagnetization, Projected from the Hysteresis Loop

3.2.5.3.1.1 The waveform at the upper right ([Figure 3-18](#)) represents the flux in the part as indicated on the diminishing hysteresis loops. Both current and flux waveforms are plotted against time, and when the current reaches zero the residual field in the part will also have approached zero. Precautions to be observed in the use of this principle are:

- Be certain the magnetizing force is high enough at the start to overcome the coercive force, and to reverse the residual field initially in the part.
- The decrease between successive reductions of current is small enough so the reverse magnetizing force will be able, on each cycle, to reverse the field remaining in the part from the previous reversal.

3.2.5.3.1.2 Frequency of reversals is an important factor affecting the success of this method. With high frequency of current reversals, the field generated in the part does not penetrate deeply into the part section since penetration decreases as frequency increases. At a frequency of perhaps one reversal per second, penetration of even a large section is probably near 100-percent. For moderately sized parts, the 50 or 60-hertz commercial frequencies of alternating current give quite satisfactory results.

NOTE

Materials heated above their Curie temperature become nonmagnetic, thus offering another method of demagnetization. However, this is not useful for field application to aircraft components as heating to the Curie temperature, or above, may damage the part.

3.2.5.3.2 Limitations of Demagnetization. "Complete" demagnetization is usually not possible, even though it is often specified. All practical demagnetization methods leave some residual field in the part. Therefore, demagnetization is either the best effort that existing means permit or reduction in magnetism to a residual level considered permissible in the particular part involved. It is extremely difficult to bring the steel back to the original zero point by any magnetic manipulation. In fact, it is so difficult that for all practical purposes, it may be said the only way to completely demagnetize a piece of steel is to heat it to its Curie temperature or above, and cool it with its length directed east and west in order to avoid magnetization by the earth's natural magnetic field, north/south. This method of demagnetization is never used because it is not only impractical, but such heating will alter the properties of the part.

3.2.5.3.2.1 Remember, the earth's magnetic field can determine the lower limit of practical demagnetization. Long parts, or assemblies of long parts, such as welded tubular structures, are especially likely to remain magnetized at a level determined by the earth's natural magnetic field, in spite of the most careful demagnetization technique.

3.2.5.3.2.2 Many articles and parts become quite strongly magnetized from the earth's natural magnetic field alone. Handling of parts, such as transporting from one location to another, may produce this effect. Long bars, demagnetized at the point of testing, have been found magnetized at the point of use. It is not unusual to find steel aircraft parts are magnetized after having been in service for some time, even though they may never have been near any intentionally produced magnetic field. Parts may also become magnetized by being near electric lines carrying heavy currents, or near some form of magnetic equipment.

3.2.5.3.2.3 The limits of demagnetization may be considered to be either the maximum extent to which the part can be demagnetized by available procedures, or the level to which the terrestrial (earth's) field will permit it to become demagnetized. These limits may be further modified by the practical degree or limit of demagnetization actually desired or necessary.

SECTION III MAGNETIC PARTICLE INSPECTION EQUIPMENT

3.3 MAGNETIC PARTICLE INSPECTION EQUIPMENT AND MATERIALS.

3.3.1 Selection of Magnetic Particle Inspection Equipment. When selecting magnetic particle inspection equipment, the inspector must consider the type of current to be used and the location and nature of inspection.

3.3.1.1 A variety of equipment is available which can be used for either circular or longitudinal magnetization. The equipment ranges in size from small, general-purpose portable units capable of being carried by hand to large, custom-built stationary units with separate power supplies.

3.3.2 Categories of Magnetic Particle Inspection Equipment.

3.3.2.1 Stationary Equipment. A variety of stationary, bench-type MPI units are available, with many characteristics that fit different testing requirements. The smaller size units are used for small parts easily transported and handled on the unit by hand. The larger ones are used for heavy parts such as long engine crankshafts, where handling must be by crane. Such units are made to deliver AC or DC with various types of current control.

3.3.2.1.1 A typical stationary horizontal wet magnetic particle inspection unit has two contact heads (headstock and tailstock) for either direct contact or central conductor, circular magnetization using a copper rod between the heads, or a cable connected to a contact block between the heads. Many of the units contain a coil used for longitudinal magnetization. The coil and one contact head are movable on rails. The other contact head is fixed; the contact plate on it being air cylinder operated, provides a means for clamping the part. The unit has a self-contained power supply with all the necessary electrical controls. Magnetizing currents are usually three-phase full-wave DC or AC depending upon usage requirements. The units are made in several different sizes to accommodate different length parts and with various maximum output currents. A

full-length tank with pump, agitation and circulation system for wet inspection media is located beneath the head and coil mounting rails. A hand hose with nozzle is provided for applying the bath. On special units, automatic bath application facilities are provided.

3.3.2.2 Mobile Equipment. The distinguishing feature of mobile equipment is the wheels the unit is mounted on. Mobile units can be easily moved to any inspection site where suitable line input voltages and current capacity are available. Mobile inspection units are available in several sizes ranging from 3000 to 6000-amperes of AC and half-wave DC outputs. The units may have remote current output, ON/OFF and MAG/DEMAG controls that permit one-man operation at the site of inspection. The units can be used with either rigid or cable-wrapped coils for longitudinal magnetization and demagnetization. Cables connected to a part or passing through it are used for circular magnetization or demagnetization. This type of equipment is sturdy and well suited for both fabrication and overhaul inspections.

CAUTION

Contact prods SHALL NOT be used on aerospace components or parts.

3.3.2.2.1 Both half-wave DC and AC outputs are included in most mobile and portable units to increase their versatility. Half-wave DC current and dry magnetic powder make the best combination for detecting subsurface flaws in welds, particularly when used with the prod method of inspection. Half-wave DC is also useful for detecting subsurface discontinuities when the wet method is used. The use of alternating current is limited to the detection of discontinuities that are open to the surface, such as cracks, and for demagnetizing parts.

3.3.2.3 Portable Equipment. Portable MPI equipment is manufactured in a variety of sizes, shapes, voltages, and current outputs. Portable equipment operates on the same principle as stationary and mobile equipment; however, the compactness allows areas to be inspected where larger equipment may prohibit access. Portable equipment is usually operated on 110 or 220 volt AC and is rated between 200 and 2 000-amperes. Portable equipment can be either AC, or a combination of AC and half wave DC. They can be used wherever an adequate 115-volt AC power source exists.

3.3.2.3.1 Portable equipment is suitable for examining small areas in large components where suspected cracks may be found. For example, critical engine mount fittings and landing gear assemblies, which are difficult to inspect in stationary units, can be examined quickly with minimum disturbance and with attention concentrated on points most subject to cracking. Portable equipment can be moved to large items in need of magnetic particle testing and inspections can often be performed without disassembly.

3.3.2.3.2 Categories of Portable Equipment.

3.3.2.3.2.1 Portable Power Pack. Portable power packs are high Amp output devices. Examples of this equipment are the Magnaflux P-1500 or DA-1500, which are capable of putting out 1500-Amps AC or HWDC fields. These power packs weigh in at 93-pounds and have a duty cycle of 2-minutes on and 2-minutes off. Field selection is determined by using the appropriate field cable connector. Current output is indefinitely variable from zero to maximum by use of the current control located on the front panel meter. The actual current output is determined by cable size and length. These units can also be found mounted to carts (e.g., KH-07).

3.3.2.3.2.1.1 Portable power packs are usually used with cables for cable-wrap generation of longitudinal magnetization and for demagnetization; or with prods, clamps, or magnetic leeches for generating circular magnetization. The portable power pack can also be used to provide current via the cables to a small stationary unit for head and coil shots.

3.3.2.3.2.2 Probes and Yokes. The term probe and yoke are virtually interchangeable in this discussion. Probes and yokes (e.g., Magnaflux DA-200 or Y-7) are versatile, lightweight (approximately 8-pounds) hand-held devices used for inspection of small parts and localized inspections of large parts. Probes and yokes are easily used and often provide adequate inspections. They are essentially U-shaped laminated cores of soft iron with a coil wound around the base of the U. Probes and yokes are capable of putting a strong magnetic field into that portion of the part that lay between the poles of the probe or yoke. When electrical current is passing through the coil, the two ends of the core are magnetized with opposite polarity and the combination is an electromagnet similar to a permanent horseshoe magnet. They are capable of putting out constant AC or pulsed DC fields with the flip of a switch. A probe or yoke may be used to induce only a longitudinal field in a part. No elec-

trical current passes through the part. They also have a duty cycle that will be defined in the operating instructions for the specific yoke. As an example, for the DA-200, duty cycle is 2 minutes on and 2 minutes off.

3.3.2.3.2.2.1 Probe and Yoke Current Induction.

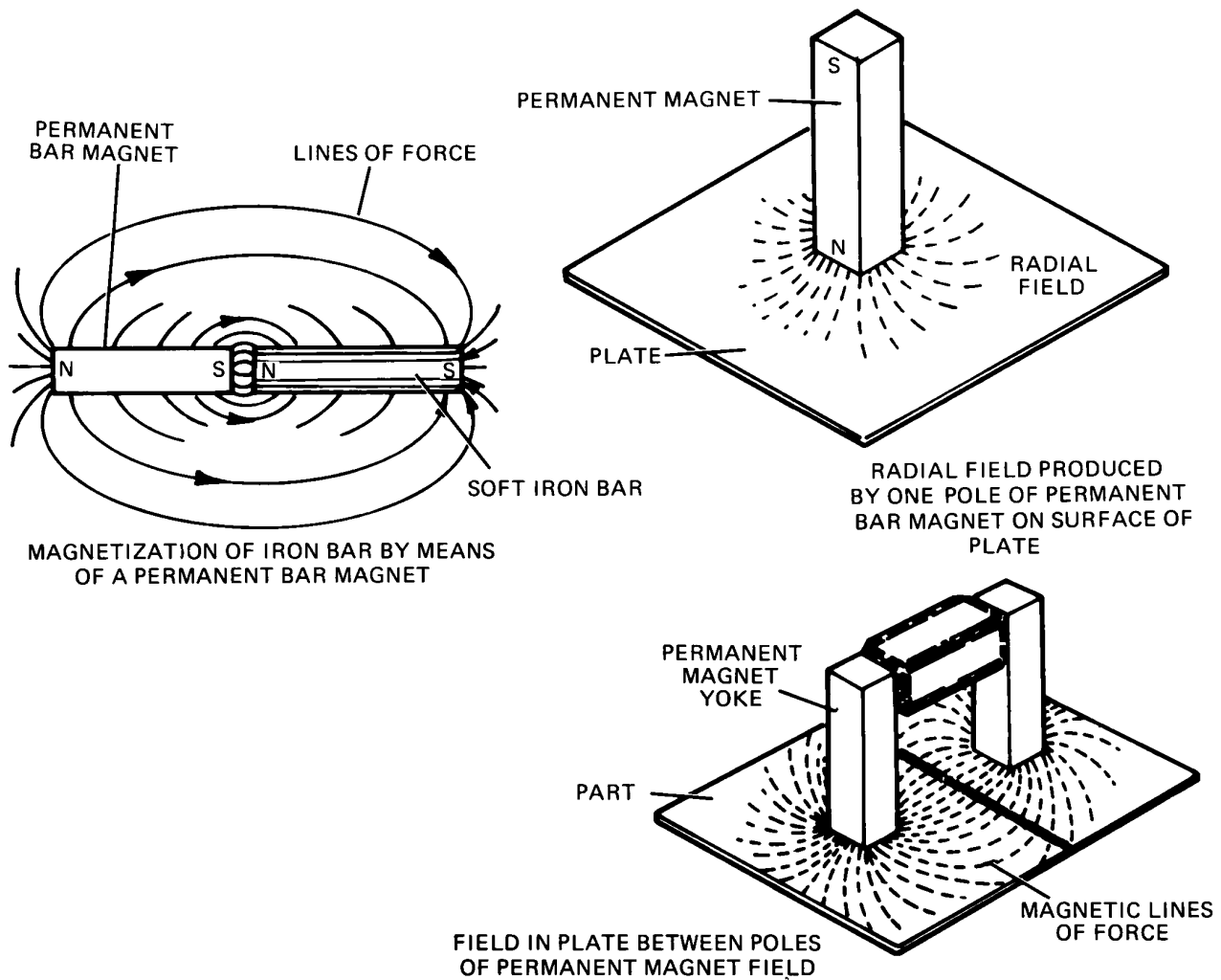
3.3.2.3.2.2.1.1 Alternating Current (AC) Probes and Yokes. Alternating current, which is single phase when used directly for magnetizing purposes, usually has a frequency of 50 or 60-hertz. The AC longitudinal magnetizing field induced in the part is restricted to the surface due to its skin effect. AC provides a very desirable field for maintenance and overhaul inspection work due to its high sensitivity to surface defects. The peak AC current produces a surge peak in the magnetic field well above the average DC current required to develop a field of equivalent strength.

3.3.2.3.2.2.1.1.1 AC magnetic fields form eddy currents that tend to guide or restrict the magnetic lines of flux into a narrow pattern between the poles. Alternating magnetic fields cause surface vibration that adds mobility to the inspection particles to form larger and more distinct build-up of particles at the defect.

3.3.2.3.2.2.1.1.2 An AC magnetic field can be used when it is necessary to discriminate between surface indications and subsurface defects that might be revealed with a DC magnetizing field. Yokes utilizing AC magnetization also have the additional advantage of being readily used for demagnetization.

3.3.2.3.2.2.1.2 Direct Current (DC) Probes and Yokes. An electro-magnet powered by DC provides a very strong magnetic field. However, being a constant field and lacking any vibratory action, it is sometimes difficult to gather enough particles at the defect to form a visible indication. To overcome this difficulty, full-wave or half-wave rectified single-phase alternating current is used. This adds mobility to the magnetic inspection particles comparable to that produced by AC.

3.3.2.3.2.2.1.3 Permanent Magnet Yokes. Permanent magnets can also be used to magnetize parts in MPI. This method of magnetization has severe limitations and is properly used only when these limitations do not prevent the formation of satisfactory leakage fields at discontinuities. Permanent magnet yokes create longitudinal fields. The poles created on the parts may result in confusing particle indications. Control of field direction is possible only over a limited area. If you stand a permanent bar magnet on end on a steel plate, it will create a radial field in the plate around the pole in contact with the plate as shown ([Figure 3-19](#)). The flux produced by this radial field travels a distance from this point of contact until it leaves the surface of the plate, only to return to the pole at the opposite end of the magnet. Cracks crossing such a field pattern may be seen provided the field produced in the plate is sufficiently strong and properly oriented. The flux generally follows along a straight line drawn between the poles, and is strongest near the poles of the yoke and weakest at the point midway between the poles. The magnetic field strength within the part depends on the strength of the yoke magnetization and the distance between the poles. Outside this limited area, the field spreads out, and cracks favorably located with respect to field direction may or may not be shown. This method of magnetization SHALL NOT be used unless the inspector is aware of, and understands the limitations of this technique.



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Figure 3-19. Magnetization With a Permanent Magnet

3.3.2.3.2.2.1.3.1 Some of the other drawbacks when using permanent magnets are:

- The strength of the field is not continuously variable.
- Large areas or masses cannot be magnetized with enough field strength to produce a satisfactory crack indication.
- It may be difficult to remove a strong magnet once it is in contact with the part.

3.3.2.3.2.2.2 Probe and Yoke Leg Configuration.

3.3.2.3.2.2.2.1 Fixed Leg Probe/Yoke. The legs of a fixed leg yoke are spaced approximately 5-inches apart providing a usable magnetic field area of approximately 25 in². Fixed leg probes can be used on flat, contoured, or irregular surfaces. However, the fixed leg position might preclude their use on some parts of a complex configuration, unless special pole pieces are available to adapt the legs to the part's surface.

3.3.2.3.2.2.2.2 Articulated Leg Probe/Yoke. An articulated or movable-leg yoke contains all the features of a fixed-leg yoke. They are, however, more versatile in their use and application because of the movable legs. The legs may be moved

inward to the decreased position or extended outward to the maximum position to obtain optimum contact, assuring a better induced magnetic field. When in the decreased position, the area of the usable magnetic field is decreased and the magnetic field is increased, permitting the detection of finer discontinuities. When in the extended position, the area of the usable magnetic field is increased though the field strength is weaker. Thus the discontinuities being sought must be larger. Movable-leg yokes are more suitable for demagnetization than fixed-leg yokes. The space between the poles or legs can be adjusted so the parts to be demagnetized pass snugly between them to obtain maximum demagnetization.

3.3.3 Inspection Equipment Accessories.

3.3.3.1 Contact Prods.

CAUTION

Contact prods SHALL NOT be used on aerospace components or parts.

When a non-aircraft part is too large to fit into a stationary unit, or if only mobile or portable equipment is available, then the part, or areas of the part, can be magnetized using cables and two hand-held prods. The current passing between the two contact prods creates a circular field. Great care SHALL be used to prevent local overheating, arcing, or burning the surface being inspected, particularly on high-carbon or alloy materials where hard spots or cracks could be produced.

3.3.3.2 Contact Clamps.

CAUTION

When parts are being magnetized by the use of spring loaded contact clamps using the direct contact method, excessively high field strength SHALL be avoided to prevent arcing, burning, or heating of the part that may ultimately impede the detection of discontinuities.

Contact clamps can be used with cables instead of contact prods, particularly when the parts are relatively small in diameter. Care SHALL be used to avoid burning of the part under the contact clamps. Dirty contacts, insufficient contact clamp pressure, or excessive currents may cause burning and heating. Cracks may be produced as a result of the transient heating. Position the clamps so it directs the current to pass through the inspection area. Make sure the circular field created is perpendicular to the direction you think cracks may be developing.

3.3.4 Special Purpose Equipment. Special purpose equipment is equipment which has been specifically designed to take care of unusual situations where standard units are inappropriate. These may be special as to the method of magnetization or particle application, or be designed to handle unusual size, shape, or number of parts. Also, these may be operated manually or automatically. Special purpose equipment can be further broken down into two groups:

- Specific Purpose Units. Equipment built to do a specific job or part, and may have no other possibility of a processing technique. This specific job may be a variation in a magnetization technique, in the way the magnetic particles are applied, or in the way parts are handled.
- Automatic Units. Automatic units are those in which part or all of the handling and processing steps are performed automatically. Either single-purpose or general-purpose units may be partly or entirely automatic. Even standard units, by addition of standard accessories, may be made automatic in some of their functions. The principal purpose of automatic units is to speed up the inspection cycle. This is accomplished through automation of one or more of the important steps involved in any given testing operation.

3.3.4.1 Multidirectional Magnetization Equipment. Complex-shaped parts can be inspected rapidly with equipment capable of producing magnetic fields in two mutually perpendicular directions in rapid succession. For large parts such as shipyard castings, the equipment produces three-phase full-wave rectified AC and rapidly switches it between several different magnetizing modes. An alternate approach, used for smaller parts, is to use each of the three phases, either rectified or unrectified, for a separate magnetizing mode. Such equipment can then apply up to three magnetizing modes in rapid succession to a part. The multidirectional units produce a multidirectional magnetization effect by rapidly changing the magnetizing di-

rections. For equipment utilizing the switched mode of operation, the switching can be on the order of 0.1 seconds. For the other type of equipment, the magnetizing modes are out of phase by 120-degrees. For 60-hertz current this is equivalent to switching magnetization directions in less than 0.006-seconds. These units are capable of producing indications of discontinuities with widely differing orientations in a single operation, thus saving the time to conduct two or more separate inspections with different magnetic field excitation setups. It is not possible to estimate the required magnetizing currents before hand to produce the required magnetic field strengths and directions. Consequently, sensors SHALL be used to determine the resulting strength and orientation of the magnetic fields in order to develop valid inspection techniques with multidirectional magnetization methods.

3.3.4.2 Induced Current Magnetization Equipment. When inspecting ring-like parts for defects in a circumferential direction, the induced current technique can sometimes be used. As an example, a ring-shaped part is placed inside and concentric to a magnetizing coil being excited with AC (Figure 3-20). A laminated ferromagnetic core is placed inside the part and parallel to the axis of the coil in order to concentrate the magnetic field. The time-varying AC induces eddy currents in the test piece, which in turn induce a circular magnetic field within the test part. Such a field is used to detect circumferential defects within the test part. The core piece used SHOULD be laminated and made of low retentivity iron. If the part is ring-shaped, the core length should be approximately equal to the ring diameter or longer, but SHALL NOT be less than six inches, and SHALL be centered in the part. For a disc-shaped part with no bore, shorter core pieces SHOULD be placed on either side of the disc so they are parallel to the axis of the part. In some cases it is advantageous to shape the ends of the core pieces adjacent to the part to facilitate bath application. Since the induced current method does not require contacting the part, there is no danger of local part overheating.

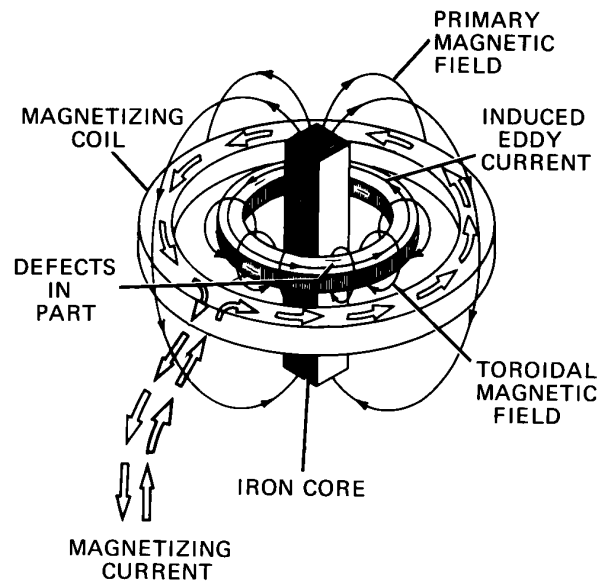


Figure 3-20. Current and Field Distribution in a Bearing Race Being Magnetized by the Induced Current Method

3.3.4.3 Hand-Held Coil. For longitudinal magnetization of shafts, spindles, rear axles, and similar small parts, the hand-held AC coil offers a simple and convenient method of inspecting for transverse cracks. Parts are magnetized and demagnetized with the same coil.

3.3.4.4 Special Demagnetizing Equipment. The most common type of demagnetizing equipment consists of an open, tunnel-like coil through which AC is passed at the line frequency, usually 60-Hertz. The larger type equipment is frequently placed on its own stand, incorporating a track or carriage to facilitate moving large and heavy parts through the demagnetizing equipment. The demagnetizing equipment can also include tabletop units, yokes, or plug-in coils more suited for the demagnetization of small parts. However, the large stationary type equipment is preferable when geometrically complex parts are involved.

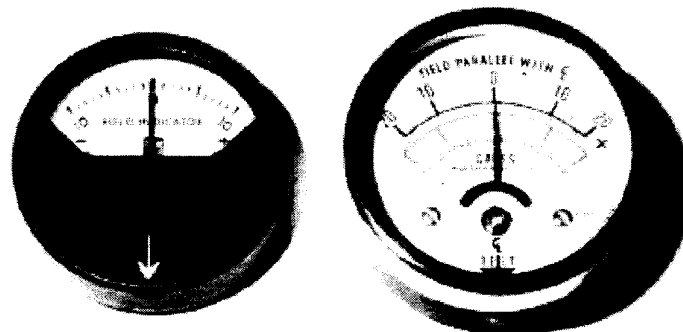
3.3.5 **Field Strength Measurement Devices.** Equipment used for testing/measuring field strength is a: dial probe, field indicator, compass indicator, steel wire indicator, Hall-effect Gauss/Tesla Meter, and Quantitative Quality Indicators (QOI).

3.3.5.1 **Field Indicator.**

CAUTION

Field indicators SHALL be kept away from fields strong enough to damage the needle because of rapid or violent deflection beyond full-scale reading. Field indicators, SHALL NOT be stored within the influence of magnetizing or demagnetizing magnetic flux.

The field indicator, a pocket instrument, is used to determine the comparative intensity of leakage fields emanating from a part. A typical field indicator is shown (Figure 3-21). The theory of operation is quite simple. When a field indicator is placed in a magnetic field, it responds to that portion of the magnetic field that passes through the sensing element of the indicator. The indicator responds to the magnetizing force of the leakage field passing through its sensing element, rather than the flux density in the part from which the leakage field emanates. When measuring the strength of the leakage field emanating from a part, the indicator senses only the field at some distance from the part. This distance is from the center of the sensing element to the bottom of the indicator when it is placed on the part's surface. The flux density of the field in the part will be greater than indicated by the field indicator. How much greater will depend upon the permeability of the part, shape of the part, and the effect of distance from the part to the sensing element in the indicator. Since these variables have an effect on determining flux density, it is recommended the field indicator be used only as a comparative indicator of the flux leakage from a part. The sensing element in newer indicators is of a ceramic-like material, which is very resistant to demagnetization.



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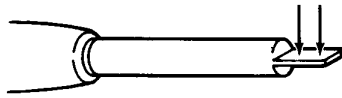
Figure 3-21. Typical Field Indicators

3.3.5.2 **Compass Indicator.** A compass is sometimes used for indicating the presence of external leakage fields. A compass can be placed upon a nonmagnetic surface and a magnetized part (aligned due east and west) moved slowly toward the east or west side of the compass case. The presence of an external leakage field from the part can cause the compass needle to deviate from its normal north-south alignment. However, demagnetized parts will cause the needle to deviate from its normal position if the compass case is not approached from an easterly or westerly direction. The theory of operation is very similar to the field indicator since the compass needle is a permanent bar magnet.

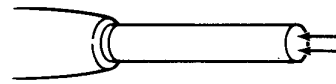
3.3.5.3 **Steel Wire Indicator.** A piece of iron or steel wire can be fashioned into a fair detector when nothing else is available. By forming a loop at one end of a piece of tag wire approximately 6-inches long, it can be suspended from a second wire supported in the horizontal plane. The part in question is then brought into contact near the free end of the vertically suspended wire. The presence of leakage fields will cause the wire to deviate from its normal vertical position as the part is slowly withdrawn in a horizontal direction. Care SHALL be taken to demagnetize the vertically suspended wire between each test. Small pieces of tag wire about 1-inch long can also be used to indicate the presence of leakage fields. The piece of demagnetized wire is placed upon a horizontal nonmagnetic surface, and the part in question is placed on top of it. If the piece of tag wire can be lifted off the surface as the part is slowly raised, the leakage fields are excessive.

AIR FORCE TO 33B-1-1
ARMY TM 1-1500-335-23
NAVY (NAVAIR) 01-1A-16-1

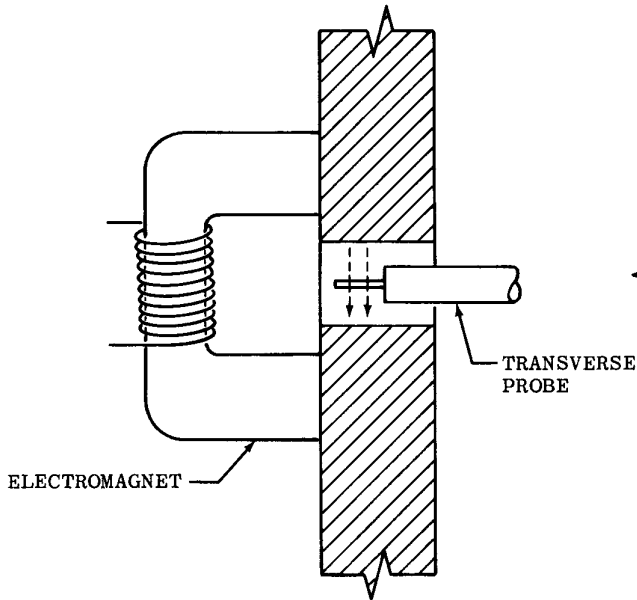
3.3.5.4 Gauss Meter. The Hall-effect Gauss (Tesla) Meter has interchangeable probes to permit measurement of the magnetic field either parallel or perpendicular to the axis of the probe. Place the probe in the hole or on the surface as shown ([Figure 3-22](#)).



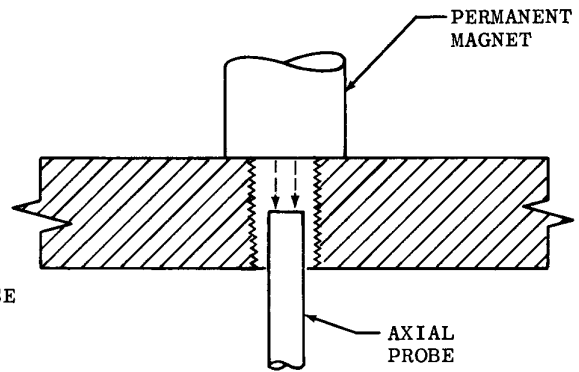
TRANSVERSE PROBE MEASURES COMPONENT NORMAL TO PLANE OF THE SENSING ELEMENT.



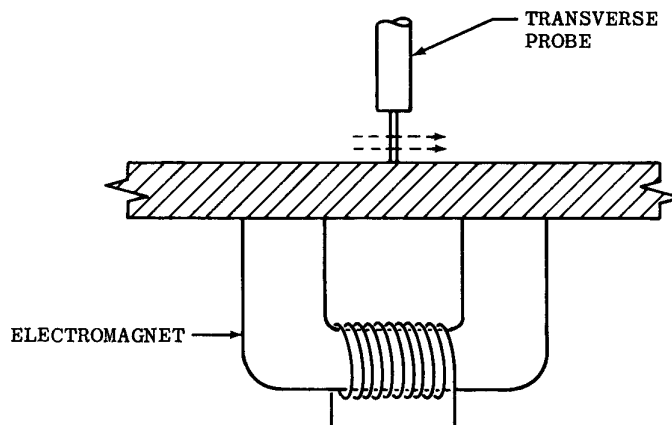
AXIAL PROBE MEASURES COMPONENT WHICH IS PARALLEL TO THE AXIS OF THE PROBE.



USE OF TRANSVERSE PROBE TO MEASURE FIELD IN HOLE.



USE OF AXIAL PROBE TO MEASURE FIELD NORMAL TO THREADS IN A HOLE.



USE OF TRANSVERSE PROBE TO MEASURE FIELD ON SURFACE

H0402003

Figure 3-22. Typical Use of Gauss Meter Probes

3.3.6 Understanding and Selecting Magnetic Particle Inspection Materials.

3.3.6.1 General. An important consideration in the magnetic particle testing process is the use of the proper type of materials to secure the best possible indications of the particular type of defect being sought under a given condition. The choice of which materials to use is important, since the appearance of the particle patterns at discontinuities will be affected by this choice, even to the point of whether or not a pattern is even formed. Since the results of magnetic particle tests depend on the interpretation of the particle pattern, the appearance of this pattern is of fundamental importance. The reproducibility of results by inspectors at different locations is dependent on the same type of particles being used by each inspector, and the same magnetizing procedure.

3.3.6.1.1 There are two basic classes of magnetic particles available for use, wet and dry. The wet method particles use a liquid vehicle for suspension; the dry method particles are borne by air. Either water or oil may be used as a vehicle for the wet method. The particles are colored to provide good color contrast with the surface being inspected. The wet particles are best suited for the detection of fine surface cracks such as fatigue cracks. They are usually used with stationary equipment where the bath can be reused until it becomes contaminated. For field applications, aerosol cans of magnetic wet bath are available. Dry particles are more sensitive for detecting defects beneath the surface and are usually used with portable equipment.

3.3.6.2 Particle Properties and Their Effects.

3.3.6.2.1 Particle Description. The particles used in the magnetic particle inspection process are finely divided ferromagnetic material, usually combinations of iron and iron oxides. Properties of these particles include the size, shape, density, magnetic properties, mobility, and color. These properties may vary depending on the application.

3.3.6.2.2 Particle Size. It is self-evident that size plays an important part in the behavior of magnetic particles in a magnetic field, which can be quite weak at a discontinuity. A large heavy particle is not likely to be arrested and held by a weak field when such particles are moving over a part surface. On the other hand, very weak fields will hold very fine powders, since their mass is very small. Consequently, extremely fine particles may adhere to the very weak leakage fields caused by acceptable surface and/or material variations. Particle size has a profound effect upon its mobility.

3.3.6.2.2.1 Dry Powder Particle Size. In general, for the dry powders, sensitivity to very fine defects increases as particle size decreases, but with definite limitations. If the particles are extremely small, on the order of a few microns, they behave like a dust. They accumulate and adhere even on very smooth surfaces. The particles will adhere at any damp or slightly oily area, whether or not leakage fields exist. Extremely fine powders, though undoubtedly sensitive to very weak fields, are not desirable for general use because they leave a heavy, dusty background. In some special applications, particles of a specific size range are used (e.g., where it is desired to detect rather large, coarse discontinuities, only large-sized particles are used). However, most dry ferromagnetic powders used for detecting discontinuities are mixtures of particles in a range of sizes. The smaller particles add sensitivity and mobility, while the large particles not only aid in locating large defects, but also by a sort of sweeping action, counteract the tendency of the fine ones to leave a dusty background. Thus, by including a wide size range, a balanced powder with sensitivity over most of the range of sizes of discontinuities is produced.

3.3.6.2.2.2 Wet Method Particle Size. When the ferromagnetic particles are applied as a suspension in some liquid medium, much finer particles can be used. The upper limit of particle size in most wet method, visible materials used for magnetic particle testing purposes is in the range of 20 to 25-microns (about 0.0008 to 0.0010-inch). Particles larger than this are difficult to hold in suspension, and even the 20 to 25-micron sizes settle out of suspension rather rapidly and are left behind as the suspension drains off. Such particles often line up in what are called drainage lines to form a watermark that could be confused with indications of discontinuities.

3.3.6.2.2.2.1 In the case of the finer particles, the stranding due to the draining away of the liquid occurs much later, giving the particles mobility long enough to reach the influence of leakage fields and accumulate to form the indications. The minimum size limit for particles to be used in liquid suspensions is indeterminate. Ferromagnetic materials commonly used include some exceedingly fine particles. In actual use, however, particles of this size never act as individuals. Because they are magnetized in use, they become actual tiny magnets. Under conditions of quiet settling in a suspension, these particles are drawn together as a result of their retained magnetism to form clumps or aggregates of particles. These aggregations then tend to act as a unit when they are applied to the surface of parts for magnetic particle testing. The speed and extent to which this process takes place increases with the retentivity of the particle material. Agitating the suspension breaks up the aggregates, but they begin to form again as soon as agitation ceases. This happens when the suspension has been applied over the surface of the part, since the particles act as agglomerated units of varying size, and not as individual particles.

3.3.6.2.2.2.2 Advantages of an Agglomeration of Fine Wet Particles. This agglomeration of fine particles into larger clumps is advantageous as long as the size of the aggregate does not become larger than the limit mentioned in [Paragraph 3.3.6.2.2.2](#). Individual particles of exceedingly small-size move very slowly through the liquid of the suspension under the influence of leakage fields at discontinuities. Unless special techniques are used, exceedingly small-size particles are not particularly useful for the location of very fine cracks until the process of agglomeration into somewhat larger units has taken place. In practical applications this process takes place while drainage of the suspension from the surface of the part is occurring. As the agglomeration proceeds the clumps formed will vary in size, and since these clumps act as individual units the effect is that of a particle size range from very fine to relatively coarse.

3.3.6.2.2.3 Fluorescent Particles. The information in [Paragraph 3.3.6.2.2.2](#) applies primarily to magnetic particles not treated with fluorescent pigments. Fluorescent particles (or even colored visible particles) must be compounded and structured to produce a pigmented or colored coating that will not readily separate from the ferromagnetic core.

3.3.6.3 Particle Shape. The shape of the magnetic particles used for magnetic particle testing has a strong bearing on their behavior in locating defects. When in a magnetic field the particles tend to align themselves along the lines of force. This tendency is much stronger with elongated or rod-like particles than with more compact or globular shapes because the long shapes develop stronger polarity. Due to the attraction exhibited by opposite poles, the north and south poles of these tiny magnets arrange themselves into strings of particles, north to south, much more readily than do globular shapes. The result is the formation of stronger patterns in weak leakage fields, as these magnetically formed strings of particles bridge the discontinuity. The superior effectiveness of the elongated shapes over the globular shapes is particularly noticeable in the detection of wide, shallow discontinuities, or of those discontinuities, which lie wholly below the surface. The leakage fields at such defects are more diffuse, and the formation of strings due to the stronger polarity of the elongated-shaped magnetic particles makes for more visible indications in such cases.

3.3.6.3.1 Dry Powders and Particle Shape. In the case of the dry powders, there is another effect from the shape of the particles which must be taken into account. Dry particles are applied to the surfaces of parts by means of plastic powder bottles, rubber squeeze bulbs, or by the use of compressed air guns. The ability to flow freely and to form uniformly dispersed clouds of powder that will spread evenly over a surface is a necessary characteristic for rapid and effective dry powder testing. A powder composed only of elongated shapes tends to gather together in the container, and to be ejected in uneven clumps. When a powder behaves in this manner, the inspection becomes extremely slow and difficult. On the other hand, globular-shaped particles flow freely and smoothly under similar conditions. A dry powder must have free-flowing properties for easy application, yet have optimum shape for the greatest sensitivity for the formation of strong indications. These two opposing needs are met by blending particles of different shapes. A fair proportion of rod-like particles must be present for a sensitive blend. A sufficient proportion of more compact shapes must be present in order to have a powder that will flow well for easy and uniform application.

3.3.6.3.2 Wet Method Particle Shape. In the case of particles for the wet method of inspection, the individual particles are kept dispersed by mechanical agitation until they are applied to the surface of the magnetized part. Therefore, no need exists to incorporate unfavorable shapes merely for the purpose of improving the flow of the particles. Long, slender particles, with otherwise desirable characteristics, could be used exclusively.

3.3.6.3.2.1 Because wet method particles are suspended in a liquid medium, which is much denser and more viscous than air, they move in the leakage fields much more slowly than the dry powders. Therefore, they accumulate much more slowly at discontinuities. In the vicinity of leakage fields, they can be seen to line up to form minute elongated aggregates. Even the unfavorable aggregate shapes, formed by simple agglomeration in suspension, will line up into magnetically held elongated aggregates under the influence of local, low-level leakage fields. This effect contributes to the high sensitivity of the fine particles comprising wet method materials.

3.3.6.4 Particle Density. Most ferromagnetic materials have fairly high densities. The densities of the materials in common use vary from around 5 to nearly 8 times the density of water. Large, heavy particles will settle out of a suspension faster than smaller, lighter particles. This constitutes one more reason for requiring magnetic particles to be small. The density of many ferromagnetic particles is lowered somewhat by compounding or coating them with pigment with densities lower than the particles; with the obvious advantage of the particles remaining suspended longer than uncoated particles. This is true of both the dry, pigmented powders and the fluorescent particles in liquid suspension.

3.3.6.5 Particle Permeability. Magnetic particles used for magnetic particle testing should have the highest permeability and the lowest retentivity possible. This is so the low-level leakage fields that occur in the vicinity of a discontinuity can easily magnetize the particles. These fields will draw the particles to the discontinuity itself and form a visible indication. However,

there is little connection between permeability and sensitivity for magnetic powders. For instance, the iron-based dry-method powders have permeabilities higher than the oxides used in the wet method. Yet a typical dry powder has less ability in detecting the extremely fine surface cracks than the wet-method particles. This is because the higher permeability is insufficient to overcome the handicaps of the other less desirable characteristics of the dry powders. Unless all other factors are in the proper range for the application at hand, high permeability alone is of little value.

3.3.6.6 Coercive Force and Retentivity Properties of Particles. As a general principle, low coercive force and low retentivity are desirable properties for magnetic particles. If these values were high in a dry powder, the particles would become magnetized during manufacture or in first use, and thus become small, strong, permanent magnets. Once magnetized, their tendency to be controlled by the weak fields at discontinuities would be overshadowed by their tendency to stick magnetically to each other and to the test surface. This acts to reduce mobility of the powder, and also to form a high level of background that obscures defect indications.

3.3.6.6.1 Wet method particles that could become strongly magnetized because of high coercive force would also form this same objectionable background. In addition, such particles would stick to any iron or steel in the tank or plumbing of an inspection unit, and cause heavy settling-out losses that would have to be made up by frequent additions of new particles to the bath. Another undesirable feature displayed by highly retentive wet method particles is their tendency to clump together quickly in large aggregates on the test surface. Excessively large clumps of material have low mobility and indications are distorted or obscured by the heavy, coarse-grained backgrounds. Therefore, particles having high coercive force and retentivity are not desirable for wet method use either.

3.3.6.6.2 Both theory and experience have shown low coercive force and retentivity are advantageous. But low does not necessarily mean minimum or none. Dry powders with some residual magnetism appear more sensitive, especially in the diffuse leakage fields formed by defects lying wholly below the surface. The reason may be the small amount of polarity established in weakly magnetized, elongated particles aid in lining them into strings when the leakage fields of discontinuities act upon them. The action is similar to the compass needle swinging in the very weak field of the earth. Similarly, wet-method particles benefit from the higher than minimum values of retentivity and coercive force. These ultra-fine particles begin to collect at discontinuities as soon as they are applied to the test surface once the agitation from the bath ceases. With insufficient retained magnetism, the particles remain fine and migrate very slowly through the liquid, due to the weak leakage fields, and the viscosity of the liquid suspending medium. The indications of discontinuities will build up, but very slowly, taking as long as five to ten-seconds. On the other hand, if excessively magnetized particles are used, the test surface is covered with large immobile clumps as soon as the bath is applied. Particles having intermediate magnetic properties collect into clumps more slowly while the indications are forming. The leakage field, strongest at the actual discontinuity, draws particles toward it, while the particles themselves are constantly enlarging due to agglomeration. At the same time, they sweep up the ultra fine particles as they move toward the defect. In this way, all the magnetic fields present work together.

3.3.6.7 Particle Mobility. When magnetic particles are applied over the surface of a magnetized part, they must move and gather at a discontinuity under the influence of the leakage field to form a visible indication. Any factor that interferes with this required movement of the particles will have a direct effect on the sensitivity of the powder and the test. Conditions promoting or interfering with mobility are different for dry and wet method materials.

3.3.6.7.1 Dry Powder Mobility. Dry powder SHOULD be applied in such a way the particles reach the magnetized surface in a uniform cloud with a minimum of motion. When this can be done, the particles come under the influence of the leakage fields while suspended in air, and have three-dimensional mobility. This condition can be approximated when the magnetized surfaces are vertical or overhead. When the particles are applied on a horizontal or sloping surface they settle directly to the surface and do not have the same degree of mobility. Tapping or vibrating the part, which jars the powder loose from the surface and permits it to move toward the leakage fields, can achieve mobility in this case. When AC or half-wave rectified AC (pulsating DC) is used for magnetization, the rapid variation in field strength while the current is on, imparts a vibratory motion to the magnetic particles on the surface of the part. This gives the particles excellent mobility for the formation of indications. The coatings applied to some of the dry-method powders to give color to the indications, also reduce friction between particles and the surface of the part, thus aiding mobility.

3.3.6.7.2 Wet Method Mobility. The suspension of particles in a liquid, which may be water or a petroleum distillate, allows mobility for the particles in two dimensions when the suspension is flowed over the surface of the part, and in three dimensions when the magnetized part is immersed in the suspension. Wet method particles readily settle out of suspension. To be effective, the magnetic particles must move with the liquid and reach every surface the liquid covers without settling out somewhere along the way. Particles settle out of suspension at a rate directly proportional to their size and density, and inversely proportional to the liquid's viscosity. While it must be balanced against many other properties, mobility is one of the

factors which is important to wet method results. The viscosity of the suspension medium is also important to mobility. In thicker liquids, the magnetic particles migrate to the leakage field more slowly. If the suspension liquid is too viscous and the magnetizing cycle too short, the indication may not form adequately. As a practical rule for sensitive inspection, the viscosity of the suspension medium SHOULD NOT exceed 3-centistokes.

3.3.6.8 Visibility and Contrast.

3.3.6.8.1 Dry Powder Visibility and Contrast. These are important properties that have a great deal to do with making a magnetic powder suitable for its intended purpose. Size, shape, and magnetic properties of a particle may be adequate, but if the indication is not visible to the inspector the inspection fails.

3.3.6.8.1.1 Visibility and contrast are promoted by choosing colors of particles easy to see against the color of the surface of the test part. The natural color of the metallic powders is silver-gray. The colors in the iron oxides commonly used as the base for the wet method materials is limited to black and red. Coloring the powder particles in some way can increase visibility against certain colors. By use of pigments the silvery iron particles are colored white, black, red, or yellow, all with comparable magnetic properties. One or another of these colors gives good contrast against the surfaces of most of the parts tested. Among the dry powders, the gray-white powder gives good contrast against the surfaces of many test parts. It fails to give good visibility, however, against the silver-gray of a sand- or grit-blasted surface, or against bright machined or ground surfaces. Choice of colors SHALL be made by the inspector to provide the best possible visibility against the surfaces of the test part under the conditions of shop lighting that prevail. Similarly, the choice of either the black or the red wet method material is made to suit particular lighting conditions.

3.3.6.8.1.2 In some cases it has been found advantageous to coat the part being tested with a color to improve contrast. Chalk or whiting in alcohol has been used in the past for the inspection of large castings and weldments when lighting conditions were poor in the areas where the inspection was being conducted. Aluminum paint has been similarly used. Color contrasting is rarely used today, because the fluorescent materials now available solve the problem in a much better way.

3.3.6.8.2 Wet Method Visibility and Contrast. The ultimate in visibility and contrast is achieved by coating the magnetic particles with a fluorescent pigment (usually available in wet method materials only). The search for indications is conducted in total or semi-darkness, using ultraviolet light to activate the fluorescent dyes used. When indications glow in the dark, it is almost impossible for an inspector not to see them. Magnetically, these fluorescent materials are less sensitive than uncoated particles, but this reduction in magnetic sensitivity is more than offset by the fact patterns of particles can be readily seen even when only a few such particles make up the indication. A fluorescent indication easily visible under UV-A is often quite impossible to see when viewed in white light. The advantage in visibility and contrast of the fluorescent materials is so great, they are being used in a very high percentage of all applications.

3.3.6.9 Media Selection.

3.3.6.9.1 Dry Method Versus Wet Method. Principally, the following influences the choice between the dry and wet methods:

- Type of Defect (surface or subsurface). Dry powder is usually more sensitive for detection of subsurface defects.
- Size of Surface Defect. The wet method is usually best for locating very fine and shallow defects.
- Convenience. Dry powder, with a portable half-wave unit, is easy to use on large parts in the shop or for field inspection work.

3.3.6.9.1.1 The dry powder method is superior for locating defects lying wholly below the surface because of the high permeability and the favorably elongated shape of the particles. These form strings in a leakage field and bridge the area over a defect. AC with dry powder is excellent for surface cracks, which are not exceedingly fine, but it is of little value for defects lying even slightly below the surface. When the requirement is to detect very fine surface cracks, the wet method is considered superior regardless of the form of magnetizing current used. In some cases, direct current is considered advantageous for use with the wet method to get better indications of discontinuities that lie just below the surface. The wet method offers the advantage of easy complete coverage of the surface of parts of all sizes and shapes. Dry powder is often used for spot inspections.

3.3.6.9.2 Visible Particles Versus Fluorescent Particles. Selection of the color of particles to use is essentially a matter of obtaining the best possible contrast with the background of the surface of the part being inspected. The differences in visibility among the black, gray, and red particles are considerable on backgrounds which may be dark or bright and which may be viewed in various kinds of light. Black stands out against most light colored surfaces, gray against dark colored ones. Red is more visible against silvery and polished surfaces especially when the lighting is from incandescent lamps. If the indication is hard to see, the inspector should try some other color of powder. In the case of the wet method, the ultimate in visibility and contrast is obtained by the use of fluorescent particles. The fluorescent wet method has been used in increasing numbers of inspection applications for many years, principally because of the ease of seeing the faintest indication.

3.3.6.9.3 Fluorescent Particle Characteristics. When exposed to near ultraviolet light UV-A fluorescent magnetic particles emit a highly visible yellow-green color. Indications produced are easily seen, and the fluorescent particles provide much stronger indications of very small discontinuities than do the non-fluorescent magnetic particles. The differences between the wet visible method and the wet fluorescent method are comparatively minor regarding suspension characteristics, maintenance and application, as well as the inspection variables and demagnetization techniques. The following applies only to the wet fluorescent method.

3.3.6.9.3.1 Advantages and Limitations. Fluorescent particles have one major advantage over the untreated or visible particles, their ability to give off a brilliant glow under UV-A illumination. This brilliant glow serves three principal purposes:

- In semi- or complete darkness even smallest amounts of the fluorescent particles are easily seen, having the effect of increasing the apparent sensitivity of the process, even though magnetically the fluorescent particles are not superior to the uncolored particles.
- Even on discontinuities large enough to give good visible indications, fluorescent indications are easier to see and the chance of the inspector missing an indication is reduced, even when the speed of inspecting parts is increased.
- Concurrent with the greater visibility of indications formed by fluorescent particles, the background caused by excessive magnetization is also more severe. Consequently, greater care SHALL be exercised in selection of the particle concentrations and magnetization levels for the inspection with fluorescent particles.

3.3.6.9.3.2 The fluorescent particle technique is faster, more reliable, and more sensitive to very fine defects than the visible colored particle method in most applications. Indications are easier to detect, especially in high volume testing. In addition, the fluorescent method has all the other advantages possessed by the wet visible suspension technique.

3.3.6.9.3.3 The wet fluorescent technique also shares the disadvantages found with the wet visible technique. In addition, there is a requirement for both a source of UV-A, and an inspection area from which the white light can be excluded. Experience has shown that these added requirements are more than justified by the gains in reliability and sensitivity.

3.3.6.9.4 Media Selection. NDI laboratories SHALL include the following supplemental information on the purchase order or contract when requesting new media.

- Suspension vehicle for magnetic particle inspection SHALL comply with A-A-59230 ([Table 3-1](#)).

Table 3-1. Requirements for Magnetic Particle Wet Method Oil Vehicle (A-A-59230)

Test	Requirement		Specification/Standard
	Minimum	Maximum	
Flash Point, °C (°F)	94 (200)	-	ASTM D93
Odor	-	None	DOD-F-87395
ASTM Color	-	1.0	ASTM D1500
Background Fluorescence	Less than the standard		DOD-F-87395
Viscosity Centistokes	-	3.0	ASTM D445
Particulate Matter, mg/L	-	0.5	ASTM D2276
Total Acid Number, mg KOH/L	-	0.015	ASTM D3242

3.3.6.9.5 Procurement Data for Magnetic Particles.

- Magnetic particles SHALL comply with ASTM E1444 and the specific Aerospace Material Specification (AMS) ([Table 3-2](#)).

Table 3-2. Procurement Data for Magnetic Particles per ASTM E1444

Type of Particles (Specification Title)	Specification
Magnetic Particle Inspection Material, Dry Method	AMS 3040
Magnetic Particles, Wet Method, Oil Vehicle	AMS 3041
Magnetic Particles, Wet Method, Dry Powder	AMS 3042
Magnetic Particles, Wet Method, Oil Vehicle Aerosol Canned	AMS 3043
Magnetic Particles, Fluorescent, Wet Method, Dry Powder	AMS 3044
Magnetic Particles, Fluorescent, Wet Method, Oil Vehicle	AMS 3045
Magnetic Particles, Fluorescent, Wet Method, Oil Vehicle, Aerosol Canned	AMS 3046

SECTION IV MAGNETIC PARTICLE INSPECTION APPLICATIONS

3.4 MAGNETIC PARTICLE INSPECTION APPLICATION METHODS.

3.4.1 Inspection Preparation.

3.4.1.1 Disassembly Requirements. There are situations when disassembly of the item is required prior to inspection:

3.4.1.1.1 Disassembly eases accessibility to most if not all surfaces, thus permitting a more thorough inspection.

3.4.1.1.2 Boundaries between two ferrous pieces, or between a ferrous and a nonferrous piece, will create a leakage field that may confuse inspection.

3.4.1.1.3 It is usually easier to handle disassembled parts for pre-cleaning, inspection, and post-cleaning.

NOTE

If the critical area of an assembly is completely accessible for inspection without any disassembly, and if the inspection medium (magnetic powder or paste) can be removed after inspection, then it is acceptable to inspect those areas or parts in place without disassembly. For example, steel propeller blades may be inspected in the blade area while they are in place on the aircraft, but to inspect the shank area, which is concealed by the hub, it is necessary to disassemble.

3.4.1.2 Plugging and Masking. When it is possible for the inspection media to become entrapped or to damage components, plugging and/or masking SHALL be used. Plug small openings and holes with hard grease or similar nonabrasive readily soluble material. This prevents the accumulation of the magnetic particles and carrier liquid where it cannot be completely and readily removed by conventional cleaning and air blasting.

3.4.1.3 Pre-Cleaning. Pre-cleaning is the removal of all foreign material (paint, grease, oil, corrosion, layout dye, wax crayon markings, etc.) which may interfere with magnetic particle testing that has accumulated since the general cleaning operation but prior to inspection.

3.4.1.3.1 Parts or surfaces SHALL be clean and dry before they are subjected to any magnetic particle inspection process. The cleaning process used SHALL NOT reduce the effectiveness of the inspection process. The cleaning process is required to remove all contaminants, foreign matter, and debris that might interfere with the application of current or the movement of the magnetic particles on the test surface.

NOTE

Thin coatings such as cadmium, chromium, or a single coat of paint, if in good condition, will not interfere with the inspection process, and do not necessarily have to be removed. Parts that have been repainted or touched up may have thicker than normal paint which may require stripping.

3.4.1.4 Selecting a Cleaning Process. The cleaning process SHALL be chosen with knowledge of the contaminant, the reaction of the cleaning process to the metal, the accessibility of the part to be inspected, whether it's on or off the aircraft, along with other specific safety precautions. No single cleaning method can assure removal of all types of contaminants and most methods are limited to the removal of only a few types of contaminants. Further, some cleaning methods require equipment that may not be adaptable to the specific job conditions (e.g., such as cleaning large parts or cleaning in place on an aircraft). Finally, some processes may cause corrosion of the part to be inspected.

3.4.1.5 Typical Cleaning Methods.

CAUTION

Only trained and qualified personnel SHALL prepare a part (e.g., chemical/mechanical stripping), which requires anything more than a simple wipe down. Improper cleaning procedures and/or materials may cause severe damage to the material. Residues from cleaning processes can remain on the part surface and contaminate the inspection. Paint removers may leave residues that either trap particles or contaminate recirculating baths. Air Force personnel SHALL refer to TO 1-1-691. Navy personnel SHALL refer to NA 01-1A-509. Army personnel SHALL refer to TM1-1500-344-23.

3.4.1.5.1 Alkaline Cleaning. Alkaline cleaners are nonflammable water solutions containing alkaline detergents that can remove certain types of oils by saponifying (converting the oil to soap) or displacement. They can be used hot or cold, as a dip or as a spray.

3.4.1.5.2 Solvent Cleaning. Solvent cleaners are an efficient and practical means of removing light preservatives and soil from parts taken out of storage or accumulate during transit and handling from the cleaning shop prior to the inspection process. Solvent cleaners dissolve oil, wax, grease, and some other contaminants and can be applied by spraying, wiping, or dipping.

3.4.1.5.3 Paint Strippers. Paint removers can be a solvent, bond release agent, softening agent, or combination.

3.4.1.5.4 Steam Cleaning. Steam cleaning is a form of alkaline or detergent cleaning and can remove loosely bound inorganic contamination and many organic contaminants from the test surfaces.

3.4.1.5.5 Ultrasonic Cleaning. Ultrasonic cleaning combines solvent or detergent cleaning with very vigorous mechanical action to loosen contaminants.

3.4.1.5.6 Mechanical Cleaning. Mechanical methods, such as wire brushing or abrasive blasting, can be used to remove rust or other corrosion deposits. These methods, if used improperly, can damage parts and conceal discontinuities (especially on soft metals) and SHOULD only be used as directed.

3.4.1.6 Preparation of Part Surface. In general, the same requirements apply for the wet method as for the dry method. Dirt, corrosion, loose scale, oil, or grease SHALL be removed. The oil bath will dissolve oil or grease, but this builds up the viscosity of the bath and shortens its useful life. With a water bath, oil on the surface of the part makes wetting more difficult, although the conditioners in the bath are usually sufficient to take care of a slight amount of oil. Excessive oil on part surfaces contaminates the water bath. Nonferromagnetic coatings, both nonmetallic (e.g. paint) and metallic (e.g. chrome), if over 0.003-inch thick, may have to be stripped. Tests have shown nonmagnetic coatings of any kind, in excess of 0.003-inch in thickness, can seriously interfere with the formation of magnetic particle indications of small discontinuities. Ferromagnetic coating (e.g. nickel) will have an even greater effect on sensitivity and may need to be stripped where they exceed 0.001 inch thick.

NOTE

When preparing for contact testing, nonconductive coatings SHALL be removed from the contact areas.

3.4.1.6.1 Surface Preparation for the Dry Powder Method. In general, the smoother the surface of the part and the more uniform its color, the more favorable are the conditions for the formation and the observation of indications. This statement applies particularly to inspections being made on horizontal surfaces. Dry powder may not be held in place on very smooth, sloping/vertical surfaces by a weak leakage field. The surface SHALL be clean, dry, and free of oil and/or grease. The dry particles will stick to wet or oily surfaces and not be free to move over the surface to form indications. This may completely prevent the detection of significant discontinuities by obscuring the flaw indications with a heavy background. On surfaces cleaned of grease by wiping with a rag soaked in a petroleum distillate, a thin film of unevaporated solvent can remain, sufficient to interfere with the free movement of the powder. This film can be removed by wiping the surface with a clean, dry cloth, flushing with alcohol, or dusting the surface with chalk or talc from a shaker can, and then wiping the surface with a clean dry cloth. An initial application of the dry magnetic powder itself, followed by wiping, can also provide a surface over which a second application of powder will move readily. Vapor degreasing (if available), will provide a dry, oil-free surface.

3.4.1.6.1.1 Any loose dirt, paint, rust, corrosion, or scale can be removed with a wire brush, by shot or grit blasting, or other allowable means. Cleaning with shot or grit blasting may cause a peening effect (especially on softer steels), which may close up fine surface discontinuities. The effect is more pronounced with shot than with grit, but if these cleaning methods are used the operator SHALL be aware of the danger of missing very fine cracks. A thin, hard, uniform coating of corrosion or scale will not usually interfere with the detection of any but the smallest defects. The inspector SHALL be aware of the smallest size defect he/she must consider, in order to judge whether or not such a coating of rust or scale should be removed.

3.4.1.6.1.2 Paint or plating on the surface of a part has the effect of making a surface defect behave like a subsurface defect. The relative thickness of the plating or paint film and the size of the defects sought, determine whether or not the coatings should be stripped. The dry method is more effective than the wet method in producing indications through such non-magnetic coatings. If fine cracks are suspected, the surface SHALL be stripped of the coating if its thickness exceeds 0.003-inch. Most coatings of cadmium, nickel, or chromium are usually thinner than this and the plating makes an excellent background for viewing indications. Hot galvanized coatings are thicker than 0.003-inch, and in general SHOULD be removed before inspections unless only gross discontinuities are important. Broken or patchy layers of heavy scale or paint also tend to interfere by holding powder around the edges of the breaks or patches and SHOULD be removed if they are extensive enough to interfere with the detection of discontinuities.

3.4.1.6.2 Surface Preparation for the Wet Suspension Method. In general, the same requirements apply for the wet method as for the dry technique ([Paragraph 3.4.1.3.1](#)). Dirt, corrosion, loose scale, paint, oil, and grease SHALL all be removed prior to inspection. When preparing for contact testing, nonconductive coatings SHALL be removed from the contact areas. The test surface SHALL be free of contaminants that can dissolve into the inspection bath.

3.4.1.6.2.1 Insoluble particulate contaminants, such as corrosion, sand, and grit left on the part surface may accumulate in a recirculating wet bath. This accumulation may interfere with the formation and visibility of indications and force the bath to be discarded sooner than normal.

3.4.1.6.2.2 The removal of surface oil and grease is very important when preparing the part prior to wet fluorescent magnetic particle inspection. Oil or grease can harm aqueous inspection baths in several ways. Their presence on the test surface can either prevent the bath from wetting and covering the entire surface, or it can cause the bath to peel off the surface, stripping any indications off with it. The oil can also be emulsified in an aqueous bath, and again coagulate the magnetic particles. Such dissolved contaminants may also become concentrated in a recirculating test bath, increasing its viscosity. Most petroleum distillates, lubricating oils, and grease fluoresce.

3.4.1.6.2.3 Moisture on the test surface can be emulsified into an oil bath causing the magnetic particles to coagulate and settle out of the bath, where they are no longer available to form indications. This contamination will gradually retard the forming of indications and make them increasingly difficult to see.

3.4.2 Magnetic Particle Inspection Techniques. There are several techniques associated with the magnetic particle inspection process. Each technique has its benefits and detriments.

3.4.2.1 Determining the Choice of Technique. The choice of technique for a particular magnetic particle inspection depends upon:

- The type of discontinuity or defect being sought.
- The part's material, shape, and size.
- The magnetic particle inspection equipment available.

3.4.2.2 Technique Variations. The following variations SHALL be considered and the appropriate alternatives selected to achieve a particular inspection result:

- Type and amount of magnetizing force required producing adequate magnetization.
- The estimated flaw size and flaw orientation.
- Type of defect; surface or subsurface.
- The magnetic particles best suited for the inspection (e.g., fluorescent, red, black, etc.).
- The method of particle application best suited for the inspection (e.g., wet, dry, or magnetic rubber).

3.4.2.3 Sensitivity Level. Any factor that affects the formation of magnetic indications at a discontinuity affects the sensitivity of that magnetic particle inspection. Three of the most important factors are: "field direction," "current level," and "control of the magnetic particle inspection media."

3.4.2.3.1 Effect of Field Direction on Sensitivity Level ([Paragraph 3.4.4.1](#)).

3.4.2.3.2 Effect of Current Level on Sensitivity Level. The formation of magnetic particle indications at discontinuities depends upon the strength of the corresponding leakage fields. Since the strength of the leakage field results from the field generated by the magnetizing current, the greater the magnetizing current, the greater will be the strength of the leakage field. Thus, the sensitivity of a magnetic particle inspection is directly related to the applied current. A current level too low produces leakage fields too weak to form readily discernible indications; and a current level that is too high creates a heavy background accumulation of particles that masks an indication. In circular magnetization, a high current level may also burn the contact points of a part.

3.4.2.3.3 Effect of Inspection Media on Sensitivity Level. Sensitivity level is affected not only by the current amperage, but also by the type of magnetic particle inspection media, its applications, and its control.

3.4.2.3.3.1 The smaller particle sizes within liquid suspensions are the most sensitive for the detection of surface discontinuities while dry powders are better for detecting subsurface defects. Fluorescent materials have a higher apparent sensitivity than do those used with visible light, such as the black and red particles.

3.4.2.3.3.2 Inspection of parts which are only moderately retentive requires careful control of the way the inspection media is applied. Usually, maximum sensitivity is obtained by applying the media while a part is being magnetized and ending it before the magnetizing field is removed, commonly known as the continuous method ([Paragraph 3.4.6.4.7.3.2](#)). This is also true in the case of automatic wet-method inspection in which the main bath stream is shut off shortly before the magnetizing current is ended to avoid washing off indications already formed.

3.4.2.3.3.3 Particle concentration in the baths SHALL be closely controlled if maximum sensitivity is to be obtained. Sensitivity is lowered if concentration of particles is too low. If concentrations are too high, fine indications may be masked by heavy background accumulations.

3.4.2.3.3.4 Contaminants, particularly in wet baths, can result in lowered sensitivity. Lubricating oils and greases for example, cause a blue background fluorescence that reduces contrast, causing fluorescent particle indications to be less visible.

3.4.2.3.3.5 Sensitivity of dry powders depends upon: "type of powder selected," "how carefully it is applied," and its "color." Most powders are made for general use and have a wide mix of particle sizes to aid in the detection of both fine surface and deep subsurface discontinuities. A powder color is usually selected which will provide the best contrast against the color of the surface upon which it is being used. Care SHALL be exercised when applying powder media. Light tossing and/or air-blowing actions are needed to allow the particles to migrate to and be held by the leakage fields at discontinuities. Excessive application of powder can cause indications to be lost in background accumulation.

3.4.2.3.3.6 The dry powder method is superior for locating defects lying entirely below the surface. This is due to the high permeability and the favorably elongated shape of the particles. These form strings in a leakage field and bridge the area over a defect. However, when the problem is to find very fine surface cracks, there is no question as to the superiority of the wet method, regardless of the form of magnetizing current used. In some cases, direct current is selected for use with the wet method to obtain the advantage of improved indications of discontinuities that lie just below the parts surface, especially on bearing surfaces and aircraft parts. The wet method offers the advantage of easy, complete coverage of the entire surface of parts. Dry powder is often used for localized inspection areas.

3.4.3 Selecting a Magnetizing Current.

3.4.3.1 Alternating Current (AC). AC in magnetic particle inspection is effective only for the detection of surface discontinuities. These types of discontinuities comprise the majority of service-induced defects. Fatigue, overload, and stress-corrosion cracks are examples of cracks usually open to the surface.

3.4.3.1.1 The shallow penetration of AC fields into the part at the usual power line frequencies of 50 and 60 hertz hinders the use of AC for the detection of subsurface discontinuities. This shallow penetration is due to a skin effect. Skin effect is the crowding of magnetic flux or electric current outward and away from the part center. Self-induced flux or currents that reduce the interior density of the flux or current causes this crowding phenomenon. Skin effect is the reason AC is recommended when inspecting for service-induced surface defects. However, the skin effect of AC is less at lower frequencies, resulting in deeper penetration of the lines of force. At 25 hertz, the penetration is considerably deeper, and at frequencies of 10 Hz and less, the skin effect is almost nonexistent.

3.4.3.1.2 The alternating currents used in magnetic particle inspection have low excitation voltages. Currents from stationary equipment range from about 100 amperes to 10,000 amperes depending upon the test part and the magnetization technique. The high currents are obtained by using step-down transformers that reduce line voltages to about 20 volts. Lower amperages are available from hand-held devices that operate from standard 115-volt outlets. Alternating current (AC) and half-wave direct current (HWDC) are obtained from single-phase systems or from one phase of three-phase systems. Full-wave direct currents (DC) are usually obtained from three-phase systems using full-wave, three-phase bridge rectifiers.

3.4.3.1.3 If the defects sought are at the surface, AC has several advantages. The rapid reversal of the field imparts mobility to the particles, especially to the dry powders. Dry powder particles in the presence of AC or HWDC fields have mobility on a surface due to the pulsating character of the fields. Particle mobility aids considerably in the formation of particle accumulations (indications) at discontinuities. The "dancing" of the powder helps it to move to the area of leakage fields and to form stronger indications. This effect is less pronounced in the wet technique.

3.4.3.1.4 Alternating current has another advantage in the magnetizing force is determined by the value of the peak current (at the top of the sine wave of the cycle). The peak current is 1.41 times greater than the current value read on the meter. Alternating current meters read more nearly the average current for the cycle rather than the peak value.

3.4.3.2 Direct Current (DC). Magnetic fields produced by direct current penetrate deeper into a part than fields produced by alternating current, making the detection of subsurface discontinuities possible. For longitudinal magnetization DC magnetizes the entire part's cross-section more or less uniformly. For direct contact (circular) magnetization a straight-line gradient of field strength (from a maximum at the surface to zero at the center) is experienced. Direct current generally is used with wet magnetic particle techniques. In the presence of DC fields, dry powder particles are relatively immobile and tend to remain wherever they happen to land on the surface of a part.

3.4.3.2.1 Pure direct current can be obtained from automotive type storage batteries. Today this technique is seldom used except in emergencies when a battery may be used to power a hand-held magnetizing device. The disadvantages of using batteries are their weight (since a number of them must be used to obtain high currents), the frequent maintenance required, their limited life cycle, and replacement cost. An advantage is the line power requirements are far less to keep the batteries charged than to power a system operating directly from line power.

3.4.3.2.2 The prevailing approach for obtaining direct current for magnetic particle inspection is through rectification of alternating current using solid-state rectifiers. A rectifier (diode) is a device that allows electric current to flow through it in only one direction. By proper connection of rectifiers, the back and forth flow of alternating current is converted to a current flow in only one direction, which is a form of direct current. A rectifier circuit which converts both alternations (back and forth flow) of the alternating current to one direction of current flow is called a full-wave rectifier.

3.4.3.2.3 Single-phase alternating current can be rectified using a full-wave rectifier circuit to obtain direct current for magnetic particle inspection. Single-phase rectification, however, is seldom used to obtain direct current, except in the case of small hand-held magnetizing devices. Since three-phase power is so readily available in industry, direct current for magnetic particle inspection units is usually obtained using three-phase full-wave rectifiers.

3.4.3.3 Comparison of Results Using Different Currents. A comparison of indications showing the same set of fine surface cracks on a ground and polished piston pin (Figure 3-23), is obtained by using 60 cycle AC, DC from storage batteries (straight DC), and DC from rectified three-phase 60 cycle AC respectively. Four values of current were used in each case with a central conductor to magnetize the hollow pin. The indications produced with AC are heavier than the DC indications at each current level, although the difference is most pronounced at the lower current values. Straight DC and rectified AC are comparable in all cases. The AC currents are meter (R.M.S. or Root Mean Square) values, so peak of cycle currents, and therefore magnetizing forces, are 1.41 times the meter reading shown.

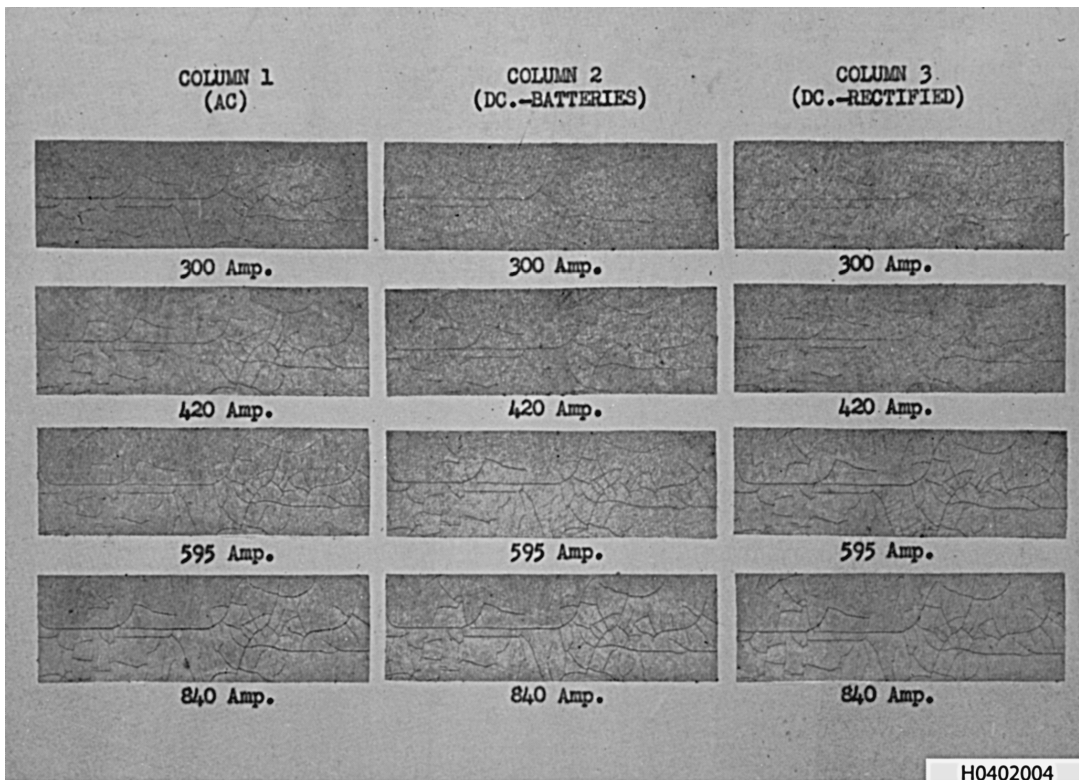
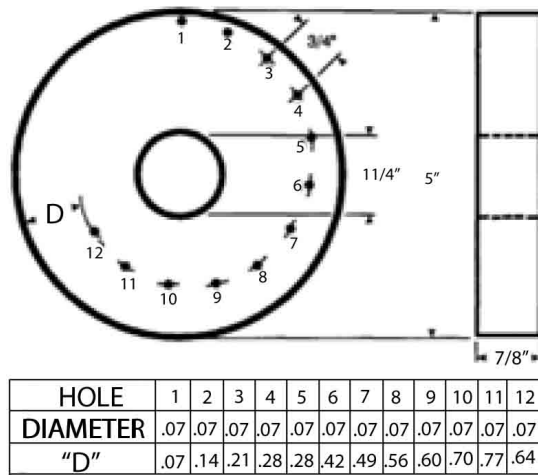


Figure 3-23. Comparison of Indications of Surface Cracks on a Part Magnetized With AC, DC, and Three-Phase Rectified AC

3.4.3.3.1 A similar comparison can be made using the Ketos ring specimen, the drawing for this is shown (left side of Figure 3-24). The specimen, made of unhardened (annealed) tool steel (0.40 percent carbon), is 7/8 inch thick. Holes, 0.07 inch in diameter and parallel to the cylindrical surface, are located at increasing depths below the surface.

Ketos/AS5282 Ring



H0402005

Figure 3-24. Drawing of a Tool Steel Ring Specimen (Ketos Ring) on Left. In-Use AS5282 Ring shown on Right.

3.4.3.3.2 For the inspection of newly manufactured parts, such as the machined and ground shafts and gears, direct current is frequently used. Although AC is excellent for the location of fine cracks that actually break the surface, DC is better for locating the very fine non-metallic stringers that can lie just under the surface.

3.4.3.3.3 Half-Wave Current provides the greatest sensitivity for detecting discontinuities that lie below the surface, particularly when using dry powder and the continuous technique. The pulsation of the half-wave current vibrates the magnetic particles, thereby aiding their migration across a surface to form indications at discontinuities. This particle mobility, which is very pronounced when dry magnetic powder is used, contrasts with the relative immobility of the powder when pure direct current is used. Due to the pulsating magnetic fields produced by half-wave current, there will be some skin effect present; however, the effect on field penetration is small at the usual frequencies of 50 and 60 Hertz.

3.4.4 Magnetic Field.

3.4.4.1 Field Direction. The proper orientation of the magnetic field in the part in relation to the direction of the defect, is a more important factor than the strength of the magnetizing current. For greatest sensitivity, the magnetic lines of force should be close to right angles to the defect to be detected. If the magnetic lines of force are parallel to the defect there will be little magnetic leakage at the defect, and therefore, if any indication is formed it is likely to be extremely small.

3.4.4.2 Right-Hand Rule. To best understand field direction and current flow, use the "right-hand-rule." The easiest way to demonstrate this rule is to grasp a straight bar in your right hand so your right thumb points in the direction the electrons would flow from negative to positive. Notice the direction your fingers curl around the bar while doing this. The direction your fingers point indicate the direction of the magnetic field in the straight bar.

3.4.4.3 Field Strength. ASTM E1444 suggests when using a Hall-Effect probe gauss meter, tangential-field strengths measured on the part surface in the range of 30 to 60 gauss (G) peak values are normally adequate magnetization levels for magnetic particle examination. A study using DC magnetizing current confirmed this field strength could produce good indications from small defects. Other studies have suggested while good to excellent indications of defects may be produced with a tangential field in the range of 30 to 60 Gauss, the background produced from acceptable surface roughness may reduce the visibility of such indications. In such cases, lower field intensity may be optimal. If the residual method is used, field strength in the range 20 to 50 gauss are normally acceptable.

3.4.4.4 Rule-of-Thumb Formulas. These are common formulas which may be identified within this manual, in ASTM E1444, or any other reliable technical publication. The inspector SHOULD be cautioned, when following "rule-of-thumb" formulas, the part length used in the L/D ratio is the part dimension measured in the direction of the coil axis, and the diameter is the dimension measured in the plane of the coil. For example, a 2-inch diameter steel bar, 10-inches long, will have an L/D ratio of 5 when the bar is placed in the coil with its axis parallel with that of the coil. If the bar is placed in the coil so the bar and coil axis are at right angles to each other, the L/D ratio will be only 0.2, a figure which, if used, would indicate the need for impracticably high amperages.

NOTE

All studies agree "rule-of-thumb" formulas for estimating magnetizing currents, contained in ASTM E1444, will usually produce field strengths well in excess of what is needed for adequate magnetization with the concurrent risk of producing a background that can hide defect indications. Always use a magnetizing force sufficient to minimize background and maximize the signal to noise ratio of the method.

3.4.4.5 Circular Magnetization. Circular magnetization is used for the detection of radial discontinuities around edges of holes or openings in parts. It is also used for the detection of longitudinal discontinuities, which lie in the same direction as the current flow, either in a part or in a part that requires the use of a central bar conductor.

3.4.4.5.1 A circular magnetic field is generated in a part whenever an electric current is passed through it or through a central bar conductor. In the case of a concentric cylinder, a circular field traveling around the inside of the part will be entirely contained within the part and thus no magnetic poles will be produced from the part. Magnetic poles will be produced if the part is not a concentric cylinder, is irregularly shaped, or the path of the current flow is not located on the part's geometric axis. In these cases, the magnetic poles are caused by a relatively small portion of the magnetic flux that passes out of the part and into the air that surrounds the part. The no pole condition in a concentric cylinder occurs both while the magnetizing current is flowing and after current flow ceases. The part is thus residually magnetized, but since no magnetic poles exist, the part appears to be in an unmagnetized state. However, if the part is cut ([Figure 3-6](#)), such as when a keyway is made, some of the field will pass out and over the cut, producing opposite magnetic poles on each side of the cut. Such poles can hold chips or metal that can interfere with subsequent machining operations or damage bearing surfaces. Care SHALL be used in the case of circular magnetization, which may not be detectable, and appropriate means to ensure demagnetization SHALL be taken. This is usually accomplished by magnetizing the part with a longitudinal field AFTER inspection with a circular field.

3.4.4.5.2 Circular Magnetization Techniques.

CAUTION

Wet the contact pads with the suspension vehicle prior to current application to help prevent overheating of the part. Ensure the contact surfaces of the part are clean and free of paint or similar coatings and have adequate pressure applied to achieve good mechanical and electrical contact over a sufficient area of the part's surface.

There are two techniques used to induce circular magnetization: the "direct contact" technique and the "central conductor" technique.

3.4.4.5.2.1 Direct Contact Technique. This technique produces circular magnetization by passing electric current through the part itself ([Figure 3-10](#)). Direct contact is applied to parts by placing them directly between the headstocks. Lead faceplates and/or copper braid pads SHALL be used to prevent arcing, overheating, and splatter. On large parts, clamping lug-terminated cables to the part using ordinary C-clamps sometimes makes current contact. Regardless of how it is made, the electrical contact SHALL be as good as practicable to minimize any over heating or arcing at the juncture. Any excessive heating at the contact points may do a number of things (e.g., burn the part, affect its temper, finish, etc.).

3.4.4.5.2.2 Central Conductor Technique. Central conductors are any conductive material, such as a copper bar or cable, placed in the center of the part to be magnetized. This technique produces circular magnetization by passing electric current through a conductor that has been placed coaxially in an opening, frequently in the center of a part ([Figure 3-11](#) and [Figure 3-12](#)). A magnetizing field exists outside a central conductor carrying current, so the walls surrounding a central conductor become magnetized. Since the circular field produced around a central conductor is at a right angle to the axis of the conductor, the central conductor technique is very useful for the detection of discontinuities that lie in a direction generally parallel with the conductor.

3.4.4.5.2.2.1 Both the central conductor and the direct contact technique can be used to detect discontinuities on the outside surfaces of tubular or cylindrically shaped parts. The central conductor technique SHALL be used if longitudinal discontinuities must be detected on the inside of tubular or cylindrically shaped parts. The direct contact technique may not produce reliable results in this case, particularly if the part is a concentric tube or cylinder with good current contact at each end.

3.4.4.5.2.2.2 The central conductor technique is also very useful for detecting discontinuities, usually cracks, which emanate in a radial pattern from holes. A part, with a hole or opening to be inspected for inside and outside discontinuities, is usually positioned with the central conductor centered coaxially in the hole or opening.

3.4.4.5.2.2.3 On very large parts with large openings, the central conductor may be located close to the inside surface and several inspections made around the inside periphery of the opening. Placing the conductor close to the inside surface reduces the current requirement since the strength of the circular field increases with decreased distance from the conductor.

3.4.4.5.3 Selection of Current Amperage for Circular Magnetization. A number of factors SHALL be considered when determining what current amperage to use for circular magnetization. Some of these factors are:

- The type of discontinuity being sought and the expected ease or difficulty of finding it.
- The part's size, shape, and cross-sectional area through which the current will flow.
- The amount of heating that can be tolerated in the part and at the current contact areas.
- The relationship between the current and the leakage fields at the surface of the part.

3.4.4.5.4 The magnetizing force at any point on the outside surface of a part through which electric current is flowing will vary with the current. The greater the current, the greater this magnetizing force. Inside the part, just under the point on the surface, the magnetic flux density will be the product of this magnetizing force and the magnetic permeability of the part at that point. It is this magnetic flux density that determines the leakage field strength at discontinuities. Thus, current is directly related to the strength of leakage fields at discontinuities, and it is these leakage fields that capture and hold magnetic particles. The more difficult the discontinuities are to detect, the weaker the leakage fields will be for a given current level. A higher current will be required to form discernible magnetic particle indications. At the same time, leakage fields from minor surface variations can attract and hold the magnetic particles, forming a background that makes indications of true discontinuities less distinct. Increasing the magnetizing force or current will also increase the intensity of this background. The correct magnetizing force or current is one strong enough to produce indications of the discontinuities which must be detected, but not too strong so the background masks the indications sought.

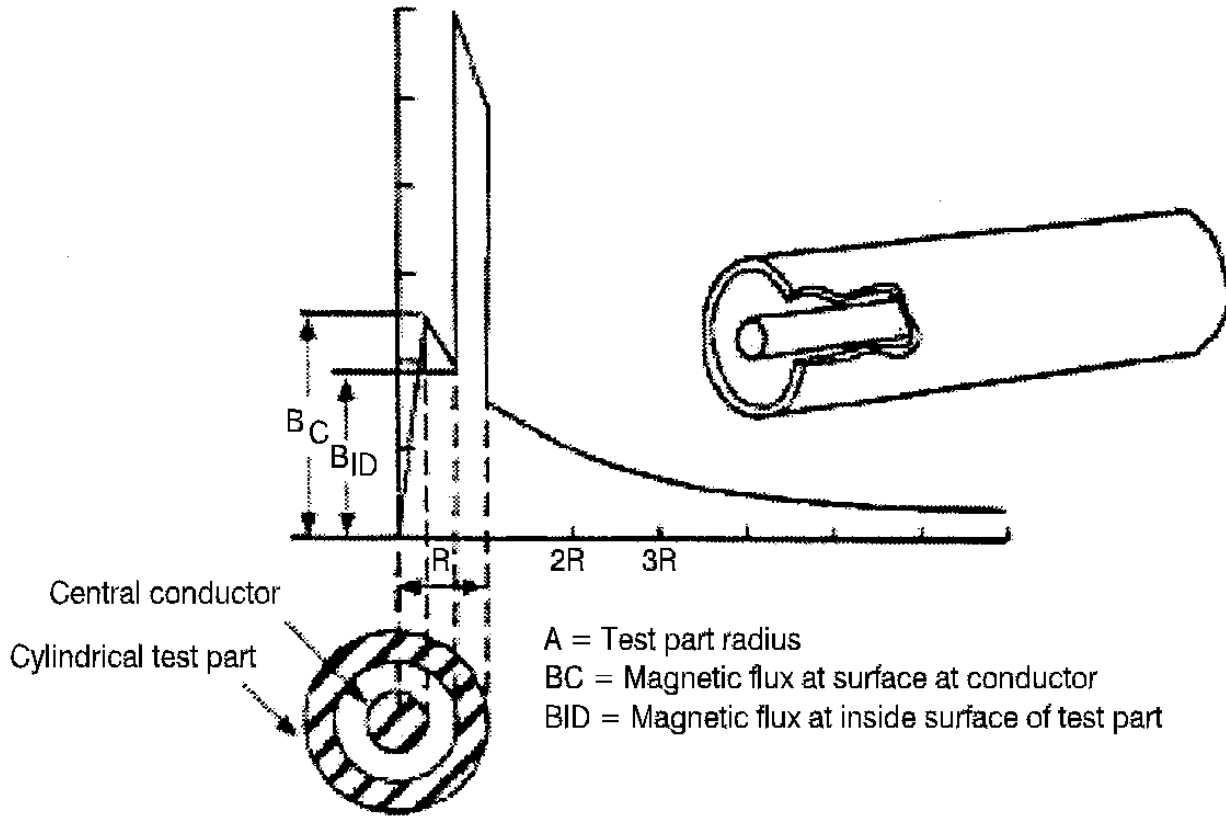
3.4.4.5.4.1 Current Amperage for the Direct Contact Technique. A problem arises when deciding what current to use for a given part, particularly when the part has a complicated shape. A "rule-of-thumb" from ASTM E1444 suggests currents from 300 to 800 amperes per inch of part diameter when the part is reasonably uniform and cylindrical in shape may be used. Except for some special alloys the use of current values in the upper half of this range will result in excessively high field strength, thus impeding the detection of discontinuities. Generally, the diameter of the part SHALL be taken as the largest distance between any two points on the outside circumference of the part. However, as a starting point, the lower limit of such "rules-of-thumb" SHALL be used as the initial magnetization current level. From this point, either use a gauss meter or shim indicators to find the correct current level.

NOTE

The use of the "rule-of-thumb" for excitation currents is fairly straightforward in the case of uniform cylindrically shaped parts. On parts having complicated shapes, such as irregular forgings, machinery parts, weldments, or castings, the use of any "rule-of-thumb" is often not practical. In these cases the inspector must rely on judgment and past experience and aids such as the shims or gauss meter previously discussed, to help in the selection of the optimum current level. Experience with similar parts, which do have discontinuities, is especially helpful in this respect.

3.4.4.5.4.2 Current Amperage for the Central Conductor Technique. Induction current requirements using a central conductor will depend upon the part's size and the diameter of the opening through which the conductor is to be located. In the case of a centrally-located conductor, suggested currents from an old "rule of thumb" may range from 100 amperes per inch of the hole diameter, to as much as 1000 amperes per inch of the hole diameter, depending upon part material and the

nature of the suspected discontinuities. Keep in mind the magnetizing field strength around a central conductor decreases with distance away from the conductor. The strongest flux field is present at the inner surface of the hole through which the central conductor passes as shown (Figure 3-25). Not only discontinuities parallel with the central conductor are detectable using the central conductor technique, but radial discontinuities at the ends of holes and openings can be detected, since some portion of the magnetic lines of force will intercept these discontinuities.



H0402006

Figure 3-25. Magnetic Flux Distribution in a Central Conductor and a Cylindrical Test Part

3.4.4.5.4.2.1 When using a central conductor, alternating current SHALL only be used when inspecting for surface discontinuities on the inside circumference of the part, unless effectiveness on the outside surface has been demonstrated using QQIs. Because the skin effect with AC current decreases the field reaching the outside surface, much higher current will be required than for the inside, and on some parts, the inspection may not be possible. If only the inside surface is to be inspected, the diameter SHALL be the largest distance between two points, 180-degrees apart, on the inside circumference. Otherwise the diameter SHALL be determined as indicated (Paragraph 3.4.4.5.4.1). The central conductor SHOULD have an outside diameter as close as practical to the inside diameter of the hole of the part being inspected and still permit access to apply solution.

3.4.4.6 Longitudinal Magnetization. A part is longitudinally magnetized when the field is approximately parallel with a major axis. A part magnetized in a coil, for example, will be longitudinally magnetized in a direction approximately parallel with the coil axis. A characteristic of a part magnetized longitudinally will be the appearance of opposite magnetic poles, north and south, at the extreme ends of the part. The existence of the poles is a disadvantage when magnetizing and inspecting, because much of the leakage flux from the pole-ends is not parallel with the part surface. This reduces the magnitude of flux that is parallel, thereby weakening the leakage fields at discontinuities in the end regions. The use of pole

pieces as described ([Paragraph 3.4.4.6.4.1](#)), overcomes this weakening effect in many cases. The poles are an advantage in demagnetizing since they make it easy to detect magnetized parts and to confirm removal of the residual fields after demagnetizing procedures.

3.4.4.6.1 Longitudinal magnetization is used for the detection of circumferential discontinuities that lie at approximately right angles to a part's axis. Circumferential discontinuities around a cylinder for example, are detected by magnetizing the cylinder longitudinally in a direction parallel with its axis. A portion of the longitudinal field will cross the discontinuities creating leakage fields that can capture and hold magnetic particles to form indications at the discontinuities.

3.4.4.6.2 **Applications.** Like all other forms of magnetization, longitudinal magnetization is used to inspect ferromagnetic components having material permeability's of about 500 or greater. This includes most steel alloys ([Table 3-3](#)). A simple test to determine whether or not a part is sufficiently magnetic is to place a permanent magnet against a part to be tested. If the attraction of the magnet can be felt, the part is sufficiently magnetic for magnetic particle inspection.

Table 3-3. Relative Permeabilities for Some Ferromagnetic Materials

Ferromagnetic Materials	Relative Permeability ¹
Iron (99% annealed in H)	200,000
Iron (99.8% annealed)	6,000
Iron (98.5% cold rolled)	2,000
Nickel (99% annealed)	600
Cobalt (99% annealed)	250
Steel (0.9% Carbon)	100

Excerpt from Nondestructive Testing Handbook, Vol. 6, American Society for Nondestructive Testing, 2^d Ed., 1988

¹ Relative to air, which has a permeability of 1.0

3.4.4.6.2.1 Discontinuities detected by the longitudinal method are those, which lie generally in a direction transverse or crosswise to the direction of the applied field. The depth at which a discontinuity can be detected depends upon the size and shape of the discontinuity relative to:

- The size of the cross section in which it is located.
- The length to diameter ratio (L/D) of the part.
- The strength of the applied magnetizing field.

3.4.4.6.2.2 The smaller the L/D ratio, for any given coil and coil current amperage, the lower will be the magnetic flux density in the part, and the weaker will be the leakage fields over discontinuities. In other words, the smaller the L/D ratio, the greater the coil current amperage must be to produce the same flux density or field strength in the part. Coil amperages become impracticably large for L/D ratios of 2 or less. If L/D is less than 2, pole piece(s) (ferromagnetic material with the same diameter as the part being examined) may be placed on one or both ends to effectively increase the L/D to 2 or greater. Long parts, with L/D ratios greater than 15, SHOULD receive multiple inspections along the length of a part. The most effective field in a part extends about 6 to 9-inches on each side of a coil. For multiple inspections, a coil SHALL be repositioned at intervals of from 15 to 18 or less inches along the part.

3.4.4.6.2.3 Longitudinal magnetization of coated parts may be accomplished depending upon the type and thickness of the coating. Metallic plating generally SHOULD NOT exceed 0.003-inch in thickness, unless it is known that the discontinuities being sought can be detected through greater thickness. Nonmetallic coatings, such as paint or other protective coatings, require removal only if they are excessively thick or damaged to the extent particles can be trapped mechanically. Any oil or grease SHALL be removed since such materials contaminate the liquid media. Any loose scale or rust SHALL also be removed from parts before inspection since they also can interfere with formation of indications and are a contaminant in a liquid bath.

3.4.4.6.2.4 Inherent with longitudinal magnetization when using a coil is the difficulty in producing good indications near the ends of the part. The leakage field that emanates from the magnetic poles generated at the part ends causes this difficulty. Longitudinal magnetization of a cylindrical part in a coil will produce free magnetic poles at the end of the part. The direction of the magnetic field in the part will be in the same direction as the magnetization force generated by the coil. However, since the flux lines are continuous, the flux lines that traverse from one pole to the other within the part will return outside the part, and in doing so travel in a direction opposite to the applied magnetizing force. This results in a reduction in field strength at the surface of the part and is called "free-pole" demagnetization. The inspection of areas near the ends of such parts is improved when the quick break in the magnetizing current is used. The resulting rapid decay of the field generates a pulse of induced current in the same direction as the original magnetizing current, which in turn produces a strong surface residual field over most of the length of a part. Parts must be moderately retentive for this type of residual inspection, and their shape must be generally cylindrical and have no long slots or cuts that would interrupt an induced current path around in the part near its outer surface. It must be mentioned the use of yokes or electromagnet magnetization will also assure an adequate inspection of the ends of generally cylindrical objects.

3.4.4.6.3 Longitudinal Magnetization Techniques.

3.4.4.6.3.1 Coil Technique. The most common way to longitudinally magnetize a part is by placing the part in a rigid coil on a stationary magnetic particle inspection unit. The part may be laid on the bottom inside of the coil where the field is strongest, or the part may be supported in the coil by the contact heads of the unit. Special supports are provided on some inspection units for long heavy parts, permitting rotation of parts for inspection. Coils are usually mounted on rails permitting movement along a long part for multiple inspections (multiple coil shots). Because the effective field extends only 6 to 9-inches on either side of a coil, multiple inspections are required along the part. The magnetizing field strength in the center of the magnetizing coil increases with the current passing through the coil and is proportional to the number of turns. The field strength decreases if the coil radius is made larger.

3.4.4.6.3.2 Cable Wrap Technique. Cable wrapping a coil around large or heavy parts is another method of producing longitudinal magnetization. Flexible, insulated copper cable is used. A cable-wrapped coil is connected to a magnetic particle mobile or portable power pack or it can be connected to the contact heads of a stationary inspection unit. The type of power source to be used will depend upon the type and level of current needed to accomplish the particular desired inspection, both magnetizing and demagnetizing.

3.4.4.6.3.2.1 Cable lengths used to connect cable-wrapped coils SHALL be kept as short as practical to minimize resistance losses in the cable and obtain higher magnetizing currents. In the case of AC, and to some extent half-wave DC, in addition to cable resistance, there is the inductance of the coil circuit which further reduces current flow. Twisting or taping the coil cable leads together aids in reducing the inductance of the coil circuit. Coil inductance increases directly with the coil opening area and increases as the square of the turns in the coil. Keeping each of these factors as small as practical, particularly when using AC, assures the maximum current will be obtainable from the power supply. To help keep coil current losses low, cable coils should be wrapped directly on a part or on some insulating material only a little larger than the part. Multiple inspections along a part, using a coil of only a few turns (3 to 5) is preferable to using a coil of many turns over the length of the part. The latter is occasionally done in some cases where performing multiple inspections is not possible or when a power pack having the required output voltage and current capacity is available. Finally, any cables and cable leads used with and for cable-wrapped coils SHALL have good quality electrical connections. Poor connections result in overheating and reduced coil amperage.

3.4.4.6.3.3 Cable Wrap Coil. Cables used are commonly 2/0 or 4/0 AWG (American Wire Gage), flexible stranded, insulated copper cable. The number of turns used is kept low, from 3 to 5 turns to minimize cable resistance in the case of DC and coil impedance when AC is used.

3.4.4.6.3.3.1 Multiple inspections, spaced approximately 15 to 18-inches along the length of a long part, are preferable to one inspection using one long coil of many turns. Cable lead lengths between the power source and coil wraps SHALL be kept as short as practical so maximum amperages are produced in the coil. When AC or HWDC is being used, twisting or taping together the cable lengths between the coil and the power supply can increase amperage. This reduces the coil-circuit impedance the same way that reducing turns on the coil does and makes it possible for more AC current to flow in the coil circuit. The total length of the cable, together with the resistance of its connections, determines the DC amperage obtainable in the coil. The longer the cable and the poorer the electrical connections, the less will be the DC and the half-wave DC amperages that can be obtained. Increased cable resistance also lowers available AC current, but in the case of AC, the impedance of the coil and coil length circuit has a much greater effect than does resistance in lowering and limiting available AC current.

3.4.4.6.3.4 Electromagnet Technique. Parts can be magnetized longitudinally by placing them between the pole pieces of a pair of electromagnets with the fields of the two electromagnets being directed in the same direction through the part.

3.4.4.6.3.5 Yoke Technique. Still another method is the magnetizing of parts between the feet of yoke or probe.

3.4.4.6.4 Selection of Current Amperage for Longitudinal Magnetization. A number of factors must be considered when determining current levels for longitudinal magnetization of parts. Some of the more important factors are:

- The coil diameter and the number of turns.
- Cross-sectional area of the part and the coil.
- The length to diameter (L/D) ratio of the part.
- The size, shape, and composition of the part.
- The orientation of the part within the coil.
- The kind of discontinuities being sought and their ease of detection.

3.4.4.6.4.1 If the need arises to inspect parts having L/D ratios of 2 or less, the effective L/D ratio SHALL be increased by placing the part with one pole piece at end or between two pole pieces while it is being magnetized. The length dimension for the L/D ratio then becomes the length of the pole pieces plus the part length. These pole pieces SHALL make good contact on each side of the part and SHALL be made of ferromagnetic material. Solid steel pole pieces may be used when direct current is used in the coil and the continuous method of inspection is used. If the continuous method is used with either AC or half-wave DC current in the coil, the pole pieces SHALL be made from laminated magnetic material similar to the silicon steel legs of a hand probe with articulated legs. This is also true for residual inspection. Pole pieces SHALL be made from the proper ferromagnetic material if residual inspection, or the wet continuous method of inspection with AC or half-wave DC, is to be used.

3.4.5 Field Strength Measurement Techniques. The measurement of magnetic flux or field strength, either within a part or at the part's surface, is extremely difficult. There are several practical methods or devices for measurement all having limitations. The most direct way of determining the magnetic field strength required is to use a specimen representative of the part to be inspected, with a defect or defects representative of those to be found. This specimen would be magnetized at sequentially higher field strengths until a good indication of the defect is formed, without an excess of background from surface conditions. This magnetic field strength could then be measured and used for parts similar to the specimen utilized (e.g. creating a "rule-of-thumb" formula). Since suitable specimens are seldom available, an alternative is to use the techniques discussed in the following paragraphs to simulate a defect and measure the necessary magnetic field strengths.

3.4.5.1 Measuring Residual Leakage Field Intensities. Leakage field intensities can be measured by quantitative or comparative methods. Quantitative measurements usually involve the use of instruments in conjunction with search coils, probes, or Hall Effect probes. Such instruments are classified as laboratory equipment and are not generally found in field locations. For purposes of determining the effectiveness of demagnetization efforts, residual field intensities are measured by comparative methods. A list of other leakage field intensity equipment (e.g. field indicator and field compass) is located in [Paragraph 3.3.5](#).

3.4.5.1.1 Another method of testing for demagnetization is to use a piece of steel feeler stock in a few thousandths of an inch thick and test if the feeler stock is attracted by the part. A small piece of iron or steel, such as a ferromagnetic paper clip, can be suspended on a string near the test part to determine if it is attracted to the part.

3.4.5.2 Field Strength Indicators.

3.4.5.2.1 Quantitative Quality Indicator (QQI). The QQI is a small, thin, metal shim, made of low carbon steel that contains artificial defects for establishing or verifying MPI techniques. Examples of QQIs are illustrated ([Figure 3-26](#)). By using an etching process that can produce very narrow (0.005 inch) flaws with tightly controlled depths, typically 15-percent, 30-percent and 60-percent of a QQIs thickness, artificial defects may be formed. The thickness of the shim is either 0.002 or 0.004-inch. The basic QQI shim satisfies most needs because its circular and crossed-bar flaw configuration is suitable for longitudinal and circular fields. The bars in the cross are 0.25 inch long, while the circular slot is 0.5 inch in di-

ameter. The circular flaw is especially useful in balancing multi-directional fields. The miniature shim is designed for small areas on a test part; each circle is 0.25-inch in diameter. The QQI with three concentric circular flaws with different depths (typically 20-percent, 30-percent and 40-percent of shim thickness) may be used for more quantitative assessment of a magnetic field; the diameters of the circles are 0.25, 0.375 and 0.5-inch in diameter. The linear shim is 2-inches long by 0.4-inch wide; it may be useful in covering a curved area of a part, such as a radius.

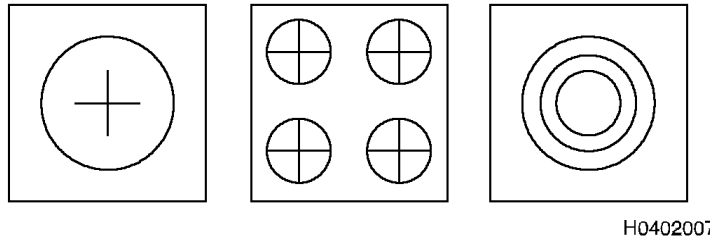


Figure 3-26. Shim-Type Magnetic Flux Indicators

3.4.5.2.1 QQIs are intended for use with the continuous method only. If a Gauss/Tesla meter is available, readings for both circular and longitudinal fields can be made at the point of QQI attachment. Once the readings are recorded for a part, it may be quicker to use the meter instead of a QQI to ensure sufficient field strength when the same type of part is inspected later.

3.4.5.2.2 Advantages of the QQI.

- It is the only device able to demonstrate adequacy and balance of multidirectional magnetization.
- It is quantitative to some extent.
- It has ultra-high permeability and virtually no retentivity.
- It can bend in one direction to conform to tightly curved surfaces. The 0.002-inch thick QQIs can conform to radii down to about 1/8-inch.
- Can be re-used with careful application and removal practice.

3.4.5.2.3 Disadvantages of the QQI.

- Its usefulness is readily destroyed with careless handling.
- It is not well adapted to dry powder applications.
- Physical size limits application to some areas.

3.4.5.2.4 Application of the QQI. To be effective, the QQI SHALL be placed flaw side down and in intimate contact with the part surface. Also, it SHALL be emphasized since the QQI responds to the field in its immediate vicinity, indications can be produced in the QQI when no other ferromagnetic material is present. Obviously, the primary rule of assuring the part is ferromagnetic before attempting an inspection applies with the use of QQIs. Additional information on QQIs is located in [Paragraph 3.6.6.3.1](#).

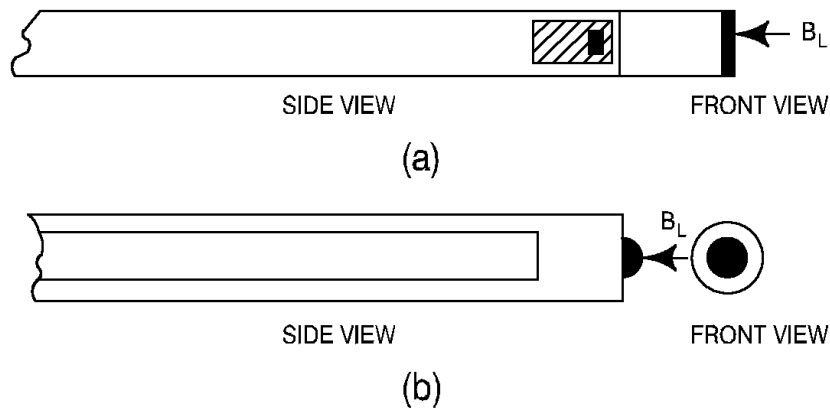
3.4.5.3 Field Strength Measurement Devices.

3.4.5.3.1 Hall-Effect Gauss/Tesla Meter. This is a portable, hand-held digital instrument that can be used to measure magnetic-field strength. It applies a current to a Hall-effect probe or sensor and amplifies the output voltage proportional to the magnetic flux density present at the sensor and is at right angles to the applied current. It can be used in establishing MPI procedures to indicate magnetic-field direction and to measure both applied and residual fields. One limitation is it measures only the flux passing through the probe or sensor (See [Figure 3-27](#)) and does not measure the field at or below the part surface.

- a. Tangential.
- b. Normal.

(The arrow represents an external magnetic leakage field " B_L " at the point of measurement.)

a) Tangential
 b) Normal
 (The arrow represents an external magnetic leakage field B_L at the point of measurement.)



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Figure 3-27. Hall-Effect Sensors

3.4.6 Methods of Particle Application.

3.4.6.1 Dry Versus Wet Application. Either the dry or the wet method for particle application can be used in the residual method. With the wet method, the magnetized parts may be immersed in an agitated bath of suspended magnetic particles, or they may be flooded with bath by a spray. In these circumstances a favorable factor occurs that affects the strength of indications. This factor is the time of immersion of the part in the bath. By leaving the magnetized part in the bath or under the spray for a considerable time, the leakage fields have time to attract and hold a maximum number of particles even at fine discontinuities. This produces an increase in sensitivity over the mere flowing of the bath over the surface of the part as it is being magnetized by the continuous method. It should be noted the location of the discontinuity on the part as it is immersed affects particle buildup. Build-up will be greatest on horizontal upper surfaces, and less on vertical surfaces or lower horizontal surfaces. Also, rapid withdrawal from the bath or spray may wash off indications held by extremely weak leakage fields. Care SHALL be exercised during this part of the process. The residual method, either wet or dry, has many attractive features and finds many applications, even though the continuous method has the inherent advantage of greater sensitivity.

3.4.6.2 Particle Description. The particles used in magnetic particle testing are made of ferromagnetic materials, usually combinations of iron and iron oxides, having a high permeability and low retentivity. Particles having high permeability are easily attracted to and magnetized by the low-level leakage fields at discontinuities. Low retentivity is required to prevent the particles from being permanently magnetized. Strongly retentive particles will cling together and to any magnetic surface, resulting in reduced particle mobility and increased background accumulation.

3.4.6.2.1 Magnetic particles may be applied as a dry powder or wet suspension. Dry powders are available in various colors so the user can select the color that contrasts best against the surface color of the part. Colors for use with ordinary visible light are red, gray, black, or yellow. Red and black colored particles are also available for use in visible light as wet suspensions. Wet suspensions use fluorescent yellow-green particles.

3.4.6.3 Dry Powder Magnetic Particles.

CAUTION

Dry powder method SHALL NOT be used on aerospace vehicles or aerospace parts without specific approval of the appropriate engineering authority for the individual inspection requirements.

3.4.6.3.1 The usual ways to apply magnetic particles in dry form are with: rubber squeeze bulbs, plastic squeeze bottles equipped with perforated caps having smaller holes than the normal saltshaker, or simply by hand. The objective is to lay down a light cloud of powder on the part being inspected. This is usually accomplished by using a combination of squeezing the bulb and/or tossing the powder toward the area being inspected.

3.4.6.3.1.1 The dry powder method is used for the inspection of welds and castings where the detection of defects lying wholly below the surface is considered important. The particles used in the dry method are provided in the form of a powder. They are available in red, black, yellow, and gray colors. The magnetic properties, particle size and shape, and coating method are similar in all colors making the particles equally efficient. The choice of powder is then determined primarily by which powder will give the best contrast and visibility on the parts being inspected and the degree of sensitivity desired.

3.4.6.3.2 Advantages and Limitations of Dry Powder. The dry powder method has good and bad features. The advantages and disadvantages, which may influence its use for a specific application, are summarized in the following list.

3.4.6.3.2.1 Good Features.

- Excellent for locating defects entirely below the surface and deeper than a few thousandths of an inch.
- Easy to use for large objects with portable equipment.
- Easy to use for field inspection with portable equipment.
- Good mobility when used with AC or half-wave (HW).
- Not as messy as the wet method.
- Equipment may be less expensive.

3.4.6.3.2.2 Bad Features.

- Not as sensitive as the wet method for very fine and shallow cracks.
- Not easy to cover all surfaces properly, especially of irregularly shaped or large parts.
- Slower than the wet method for large numbers of small parts.
- Not readily usable for the short, timed shot technique of the continuous method.
- Difficult to adapt to a mechanized test system.

3.4.6.3.3 Dry Powder Selection for Visibility and Contrast. Selection of the particle color to use is essentially a matter of obtaining the best possible contrast against the background of the surface of the part being inspected. The differences in visibility among the black, gray, yellow, and red particles are considerable on backgrounds which may be dark or bright, and which may be viewed under various light conditions. If difficulty is experienced in seeing indications, the inspector SHOULD try a different colored powder. Available colors for the dry powder method are:

3.4.6.3.3.1 Gray Powder. This is a general-purpose high contrast powder and by far the most widely used of the dry powders. It is effective on dark surfaces, whether black, gray, or rust colored.

3.4.6.3.3.2 Black Powder. This is especially designed for use on light colored surfaces. It is dust-free as well as the most sensitive of the dry powders. Its higher sensitivity is because it contains the highest proportion of magnetic material of all the dry powders.

3.4.6.3.3.3 Red Powder. This is a dark reddish powder used on light colored surfaces, as is the black powder. However, since the black powder on a silvery or polished surface is sometimes hard to see, the red color may offer a better contrast, particularly under incandescent lighting where the red color stands out.

3.4.6.3.3.4 Yellow Powder. This pale yellow powder features fair sensitivity and good contrast on dark colored surfaces.

3.4.6.3.4 Applying the Dry Powder. A few rules for the application of dry powder will make the process of testing easier and more effective. Dry particles are heavier and individually have a much greater mass than the very fine particles used in the wet method. If they are applied to the surface of a part with any appreciable velocity, the fields at the discontinuities may not be able to stop and retain them; this is especially true when vertical or overhead surfaces are being examined. The powder SHOULD reach the surface of part as a thin cloud, with practically zero velocity, drifting to the surface, so the leakage field has only to hold it in place. The fields of vertical and overhead surfaces must overcome the pull of gravity, which tends to cause the particles to fall from the part. Since dry particles have a wide range of sizes, the finer particles will be held under these conditions, unless the leakage fields are extremely weak. This problem is minimized on horizontal surfaces. The usual mistake is to apply too much powder. If too much powder is applied to a horizontal surface, the powder will have no mobility (unless AC or HWDC is being used) and this too heavy of an application will tend to obscure indications. If the part can be lifted and tapped, the excess powder will fall away and indications will be more readily visible. The excess powder can also be gently blown away with an air stream, which is not strong enough to blow off magnetically held particles forming an indication.

3.4.6.3.4.1 Dry Powder Applicators. Various devices have been used to make proper powder application easy. The squeeze bottle is light and easy to use. With some practice, by a combination of shaking, as with a saltshaker, and a squeeze of the bottle, powder can be ejected with minimum velocity. Practicing with the bottle on a sheet of white paper will assist in training the inspector to produce an even, gentle overall coverage. A powder gun or blower improves application, especially on vertical and overhead surfaces. The powder gun throws a cloud of powder at low velocity, much like a very thin paint spray. When held about one-foot from the surface being inspected, a very light dusting of powder permits easy observation of the formation of indications. On horizontal surfaces the excess of powder is blown away with a gentle air stream from the blower. Two push-button valves on the blower gun control the flow of powder or clean air. Less powder is used with the gun, which helps to assure a better inspection. A more elaborate gun-type powder blower has a motor-driven compressor integral with a powder container and air-powder mixer. The gun is connected to a multi-channel rubber hose and a work light is contained in the gun tip to illuminate the inspection area. A trigger on the gun controls the discharge of the powder-air mixture and blow-off air. More elaborate production systems have been built using this same principle of operation. In these cases, the discharge nozzles are mechanically controlled, as is the movement of parts through the machine. Spent powder is automatically retrieved and reused.

3.4.6.3.5 Effects of Part Surface Condition/Orientation. When the surface is horizontal, clean, smooth surfaces are best for successful dry powder inspection. If the surface is rough, powder tends to gather and be held mechanically in depressions on the rough surface. A stronger stream of air than normal may be required to blow off this loose powder. Care SHALL be taken during the inspection of rough areas (for example, a rough weld bead), so weakly held indications are not also blown away. By watching the area very carefully during powder application and while blowing off the excess, you can often see the weak indications as the powder shifts. For very critical inspections, the weld bead is sometimes machined away. Indications of discontinuities, which are below the surface, are more readily formed on the smooth machined surface of the weld. If the surface being tested is vertical or even at an angle to the horizontal, an extremely smooth surface becomes a disadvantage, since the dry powder tends to slide off easily, and weak leakage fields may not be able to hold it in place. Under these circumstances, a slightly roughened surface gives better results.

3.4.6.3.6 Inspection Technique Variables. The two basic inspection variables to be considered are the type of current to use, and the current/particle application technique. The type of current is dictated by the location of the defects, whether they are on the surface of the part, or located entirely below the surface. The choice of current is between AC and some form of DC. If the defect is on the surface, either AC or DC may be used, and the choice is determined by other considerations. AC SHALL NOT be used if the defect lies below the surface.

3.4.6.3.7 Current Selection for the Dry Powder Method. AC versus DC is the first basic choice to be made, since the skin effect of AC at 50 or 60 hertz limits its use to the detection of defects on the surface, or only a few thousandths of an inch

below it. However, the skin effect of AC is less at lower frequencies, resulting in deeper penetration of the lines of force. At 25 hertz the penetration is deeper, and at frequencies of 10 hertz and less, the skin effect is almost nonexistent.

3.4.6.3.7.1 If the defects sought are on the surface, AC has several advantages. The rapid reversal of the field imparts mobility to the particles. The dancing of the powder helps it to move to the area of leakage fields and to form stronger indications. Alternating current has another advantage. The magnetizing effect is 1.41 times that of the current read on the meter. To get equivalent magnetizing effect from DC more power and heavier equipment is required.

3.4.6.3.7.2 DC on the other hand, magnetizes the entire cross section uniformly in the case of longitudinal magnetization. Direct contact (circular) magnetization produces a field that varies linearly from a maximum at the surface to zero at the center of the bar. The types of DC are; straight DC from batteries, full wave rectified three phase AC, and full wave and half-wave rectified single phase AC.

3.4.6.3.7.3 For the inspection of finished parts, such as the machined and ground shafts and gears of precision machinery, DC is frequently used. Although AC is excellent for the location of fine cracks that actually break the surface, DC is better for locating very fine nonmetallic stringers lying just below the surface. It is usually important to locate such stringers in parts of this type, since they can initiate fatigue failures. These comparisons point out the importance of choosing the right current type to give the best indications possible, and show how the choice will vary, depending upon the nature and location of the defects sought.

3.4.6.3.8 Current/Particle Application Technique. The use of dry powder with the residual inspection has several disadvantages:

- It is more difficult to apply to interior regions of a part than is wet media.
- It is more difficult to completely cover a part in a short time.
- Removal of powder from a part can be a problem.

3.4.6.3.9 Dry Powder Inspection Guidelines. Proper illumination and good eyesight are the principal requirements for observing the presence of indications on the surface of parts. Selection of the best color powder for contrast against the surface is an aid to visibility. Last, but certainly not least, magnetization SHALL be sufficient to generate a useable leakage field at the location of discontinuities, but not excessive to where the background degrades the contrast of any indications formed. On large discontinuities, dry powder build-up is often very heavy, making indications stand out clearly from the surface. Finer cracks produce less build-up, since the leakage field holds fewer particles. Extremely fine cracks require some form of the wet method, which is more sensitive to very fine discontinuities and SHOULD be used.

3.4.6.3.9.1 The same requirements for proper inspection of surfaces apply for the detection of subsurface discontinuities. The depth below the surface and the size and shape of the discontinuity determine the strength and spread of the leakage field. A proficient inspector will observe the surface as the powder is allowed to drift onto it, and will see faint but significant tendencies of the powder to gather. Often indications are seen under these conditions, but are no longer visible when more powder has been applied, the excess blown off, and the surface then examined for indications. Standardized techniques for careful and proper application of the powder can help assure the required sensitivity is achieved where similar assemblies are repetitively tested.

3.4.6.3.9.2 Indications are held at the defect by the residual field for highly retentive steels. In low carbon steels, the retentivity is very low. On these steels it is important to perform the inspection while the magnetizing current is on and the powder is being applied, since indications may not remain in place after the current is turned off. This is particularly true on vertical and overhead surfaces, where gravity plays a part in causing particles to fall away if lightly held. However, inspection requirements for the higher retentive steels often require the detection of very small defects. Even though the residual field may be high in such steel, the leakage fields for small defects will also be small, and therefore the indications are not held at the surface very well.

3.4.6.4 Wet Suspension. Either water or a high flash point petroleum distillate is used as a wet suspension vehicle.

3.4.6.4.1 Water Suspensions.

CAUTION

The use of water suspensions SHALL be carefully controlled to prevent corrosion and provide wetting of ferromagnetic aerospace components. Wetting agents and corrosion inhibitors SHALL be used with water suspensions. Weekly monitoring of corrosion inhibitor and wetting agent concentrations SHALL be conducted per the process control section in TO 33B-1-2 WP 103 00.

Usually, the magnetic particle concentrates provide the correct amount of wetting agent and corrosion inhibitor for initial use. However, these materials are also available separately so the concentrations can be maintained or adjusted to suit the particular conditions. If no corrosion can be tolerated, a higher concentration of corrosion inhibitor will be used. Acidity SHALL be checked weekly and the pH of the water bath SHALL be between 6 to 10. If the part being inspected has a residual solvent film, more wetting agent is required so the part surface will be completely wetted. Breaking of the bath into rivulets as it is applied over a part is an indication additional wetting agent is required or the part requires further cleaning. A water break test SHALL be conducted daily using a clean specimen or part having the smoothest surface finish to be inspected. The specimen SHALL be flooded with bath and examined once flooding is stopped. If a smooth continuous film of bath forms over the entire surface, sufficient wetting agent is present. Reference SHALL be made to the manufacturer's recommendations for the correct quantity of wetting agent to be added.

3.4.6.4.2 Petroleum Distillate Suspensions. No additives other than the magnetic particles themselves are used with petroleum distillate suspensions. Petroleum distillate recommendations are included in manufacturer publications or specifications.

3.4.6.4.3 Advantages and Disadvantages of Wet Suspension. As is true of every process, the wet method has both good points as well as less favorable characteristics. The more important good points of the wet method, which constitute the reason for its extensive use, as well as the less attractive characteristics, are tabulated as follows:

3.4.6.4.3.1 Advantages.

- It is the more sensitive method for very shallow fine surface cracks.
- It quickly and thoroughly covers all surfaces of irregularly shaped parts, large or small, with magnetic particles.
- It is the faster and more thorough method for testing large numbers of small parts. The magnetic particles have excellent mobility in liquid suspension.
- It is easy to measure and control the concentration of particles in the bath, which makes for uniformity and accurate reproducibility of results.
- It is easy to recover and reuse the bath.
- It is well adapted to the short, timed shot technique of magnetization for the continuous method. It is readily adaptable to automatic unit operation.

3.4.6.4.3.2 Disadvantages.

- It is not usually capable of finding smaller defects lying entirely below the surface, if more than a few thousandths of an inch deep.
- It is messy to work with, especially when used for the expendable technique, and in field-testing. A recirculation system is required to keep the particles in suspension.
- It sometimes presents a post-inspection cleaning problem to remove magnetic particles clinging to the surface.

3.4.6.4.4 Wet Suspension Characteristics. Wet method particles may be suspended either in water or in a petroleum distillate. Water is initially cheaper, but it requires additives to make it a suitable medium for suspending the wet magnetic particles. Wetting agents, anti-foaming materials, corrosion inhibitors, suspending and dispersing agents are necessary and SHALL be carefully controlled. In order to assure proper control of the various conditioners, water SHALL NOT be used as a suspending liquid unless adequate process control capabilities are present.

3.4.6.4.4.1 Particle Characteristics. Dry material concentrates to be used in water suspension SHALL contain all of the extra ingredients necessary to make the finished suspension. Cost of the concentrate is comparable for water or oil suspension.

3.4.6.4.4.1.1 The need to incorporate all of the special ingredients for water or oil suspension into the concentrate necessitates two separate and distinct products. Water-suspendible concentrates cannot be used in oil. The various additives for water-suspendible concentrates are insoluble in oil and will not disperse the particles in an oil bath. Alternatively, the additions made to the concentrates intended for oil suspension are not soluble in water. However, with suitable water conditioners, some of the oil-suspendible concentrates can be used in water.

3.4.6.4.4.1.2 One outstanding characteristic of the wet visible method particles is their extremely small size. These very fine particles do not act as individuals but agglomerate into groups. Dry concentrates are almost always formulated to include all required constituents.

3.4.6.4.4.1.3 Oil-/Water-Suspension Power Concentrate. The requirement to meet a variety of conditions for successful magnetic particle testing has resulted in the development of different materials to obtain this result. The most commonly used materials, black and red oil/water suspensions, are listed below with the special characters of each:

- **Black Power Concentrate.** This is available as an oil- or water-suspension powder. It is especially suited for finding fine cracks on polished surfaces, such as bearings or crankshafts. It is the most sensitive of the non-fluorescent wet method powders for such applications.
- **Red Power Concentrate.** This is available as a reddish brown oil- or water-suspension powder. The red color provides improved contrast and visibility in situations where the contrast of the black powder is poor. The color tends to be more visible than the black under incandescent light.

3.4.6.4.4.2 Vehicle Characteristics. The bath liquid or vehicle may be either a petroleum distillate or water. Both require conditioners to maintain proper dispersion of the particles and to permit the particles mobility to form indications on the surfaces of parts. These conditioners are usually incorporated with the powders.

3.4.6.4.4.2.1 Petroleum Distillates Characteristics.

WARNING

Lighter distillates have even lower viscosities than those used, but they have other properties undesirable in a magnetic particle bath. For example, lower initial boiling points accompany the lower viscosities, and results in faster evaporation losses. In addition, a lower flash point also accompanies the lower viscosity with the resulting increase in fire hazard. Inhalation of fumes from a light distillate can impair an inspector's health. The odor of distillate can be a distraction for the inspector and is associated with color and sulfur content.

Petroleum distillates were the first choice as a suspension liquid. Significant characteristics for a suspension vehicle are low viscosity, odorless, low sulfur content, and a high flash point. The specifications for a suitable vehicle are given in [Table 3-1](#). Of these properties, viscosity is probably the most important from a functional standpoint. High viscosity will retard the movement of particles under the influence of leakage fields, thus slowing the build-up of particles to form indications.

3.4.6.4.4.2.2 Water Suspension Characteristics.

WARNING

Equipment SHALL be thoroughly and positively grounded.

Since water is a conductor of electricity, equipment using water is designed to isolate all high voltage circuits to avoid all possibility of an inspector receiving a shock. Corrosion of equipment can occur if proper provision is not made to avoid this. However, equipment designed for use with water suspension liquid is safe for the inspector, and minimizes the corrosion problem. There is no restriction on the water to be used for the bath, as there is with oil. Ordinary tap water is suitable, and hardness is not a problem, since the mineral content of the water does not interfere with the conditioning chemicals necessary to prepare the bath.

3.4.6.4.4.2.2.1 The advantages of water versus oil for magnetic particle wet method baths are lower initial costs, lower viscosity (about 1-centistoke), not flammable, and readily availability. The disadvantages of water include potential corrosion, electrical conductivity, freezing, and the requirement for more conditioners to assure adequate particle function.

3.4.6.4.4.2.2.2 Water baths, without auxiliary heating, can be used only in shop areas where the temperature stays above freezing. Anti-freeze liquids SHALL NOT be used because the viscosity of the bath will then exceed the maximum allowable standards. Because detergents that assure wetting of surfaces can cause foaming of the bath, circulation systems SHALL be designed to avoid air entrapment or other conditions that produce foam. Anti-foaming agents help minimize this tendency, but are not 100-percent effective.

NOTE

The use of water bath suspension is not recommended for field NDI laboratories unless adequate base laboratory facilities exist to test the serviceability of the wetting agents, dispersing agents, corrosion inhibitors, anti-foam agents, and other additives required in the water suspension. Where water is used, baths SHALL be carefully controlled to prevent corrosion and ensure adequate wetting of parts to be inspected, procedures are published in TO 33B-1-2 WP 103 00.

3.4.6.4.4.2.3 Wetting agents and rust inhibitors SHALL be used with water-type wet baths. Usually, the magnetic particle concentrates provided include the correct amounts of wetting agent and corrosion inhibitor for initial use. However, these materials are available separately so concentrations can be maintained or adjusted to suit the particular conditions. Reference SHALL be made to the manufacturer's recommendations for the correct quantity of wetting agent to be added.

3.4.6.4.5 Wet Suspension Particles. Many techniques are used to apply liquid suspension magnetic particles. These range from simple hand pouring of the suspension onto a part, to large industrial systems in which the suspension is applied automatically by dumping or spraying. The most common technique for application is through the use of a hand-held nozzle and recirculating pump on the stationary units. Other forms of application are hand-held, lever-operated sprayers or aerosol-type cans similar to those used for spray paint.

3.4.6.4.5.1 Wet Particle Visibility.

CAUTION

The wet visible method SHALL NOT be used on aerospace vehicles or aerospace vehicle parts without specific approval of the appropriate engineering authority for the individual inspection requirements.

Once wet method magnetic particles are dispersed in the suspending liquid, they are fundamentally similar to each other. In past years, the most common form of the material concentrate was a paste. Today, however, the pastes have been almost exclusively reformulated and produced as dry powder concentrates. These powders incorporate the needed materials for dispersion, wetting, corrosion inhibition, etc. The powders are much easier to use, as they need merely to be measured out and added directly to the agitated bath. The agitation system of the modern magnetic particle units will pick up the powder and quickly disperse it in the bath.

3.4.6.4.6 Suspension Agitation. The magnetic particles are considerably heavier than the vehicle in which they are suspended. When the agitation system is turned off, the particles will rapidly settle out. All particles SHALL be agitated into suspension before conducting any inspections or concentration tests. This agitation time varies with downtime due to compacting of the particles from their own weight. The following schedule SHALL be followed to ensure particles are agitated into the suspension. When the agitation system has been off for:

- One or more weeks a 60-minute agitation SHALL be performed.
- Four or more hours a 30-minute agitation SHALL be performed.
- Thirty minutes to 4-hours a 10-minute agitation SHALL be performed.
- Less than 30-minutes does not require a pre-agitation

3.4.6.4.7 Wet Suspension Particle/Field Application Techniques. There are two techniques used to apply the particles: the residual technique or the continuous technique. The method to use in a given case depends upon the magnetic retentivity of the part being inspected, and the desired sensitivity of the inspection to be made. Highly retentive parts may be inspected using what is called the residual technique. The part may be magnetized first, and particles applied after the magnetizing force has been turned off (the residual technique). The other technique, continuous, SHALL be used on parts having low retentivity. The part may be covered with particles while the magnetizing force is still present (the continuous technique). For a given magnetizing current or applied magnetizing field, the continuous approach offers the greatest sensitivity for revealing discontinuities. With parts having high retentivity, a combination of these techniques is sometimes used.

3.4.6.4.7.1 Application of Suspension. There are many techniques to apply magnetic particles. The techniques range from a simple pouring of a bath onto a part, to large industrial systems in which the bath is applied automatically, either by immersion or flooding, and then recirculated for reuse. Occasionally small hand-held, lever-operated sprayers are used. Various sizes of ordinary pressurized paint spray tanks equipped with special guns are used, particularly with water-type baths.

3.4.6.4.7.1.1 Aerosol Cans. Prepared bath is widely available in aerosol cans. Such cans, usually containing oil-based baths, are very convenient to use for spot-checking, or small area tests in the field. They are often furnished in kits, including a permanent magnet or electromagnetic yoke, which makes a portable package for small field-testing jobs or for maintenance testing around the shop.

NOTE

- Aerosol containers SHALL be demagnetized to less than two increments on the magnetic field indicator, or three gauss on the gauss meter prior to performing an inspection. If inspection fluid does not spray freely, replace spray nozzle or can.
- Shelf life dates on aerosol containers of magnetic particle materials are the final date the manufacturer will warranty its product. These products SHALL only be used after this date provided there is sufficient propellant remaining in the container and they pass the system effectiveness check (TO 33B-1-2 WP 103 00). Only aerosol containers being used to perform inspections require testing.
- Aerosols require a system effectiveness check prior to each use.

3.4.6.4.7.2 Wet Suspension Application Precautions. There are many techniques used to apply magnetic particles in vehicle. The techniques range from simply pouring bath onto a part, to large industrial systems where the bath is applied automatically, either by immersion/flooding where it is then recirculated. Occasionally, small hand-held, lever-operated sprayers are used to apply bath. Prepared bath is also widely available in prepackaged aerosol cans.

3.4.6.4.7.2.1 A technique practiced, mostly on small parts, is where the parts are magnetized one at a time, and then placed in a tray and immersed into a tank containing an agitated bath of magnetic particles. Sometimes, a similar situation occurs when closely laying parts in the coil prior to flooding and magnetizing them. Precaution SHALL be taken to place these parts in the tray so they do not touch each other; or else non-relevant indications from magnetic writing may be produced at the points of contact. Haphazard loading into a basket for immersion application SHALL NOT be permitted.

3.4.6.4.7.2.2 Additional Precautions. Bath concentration and immersion time also affect the production of indications. In addition, if the leakage field at the discontinuity is weak, prolonged immersion may permit more particles to come into the influence of the field and makes the indication more visible.

3.4.6.4.7.3 Method of Current Application. The residual method requires two steps: magnetization and application of particles, plus the added time for indications to build-up if the immersion method is used. It is frequently used with AC on highly retentive materials because the alternating current field produces excellent mobility of the particles. The continuous method is preferred unless special circumstances make the residual method more desirable.

3.4.6.4.7.3.1 Residual Application Technique. The residual inspection technique for applying magnetic particles, either dry powder or a liquid suspension, is applied after magnetization. This technique is used only when parts are magnetized with DC and when parts have sufficient retentivity to form and retain adequate magnetic particle indications at discontinuities. This technique can be used with both longitudinal and circular magnetization with either direct contact or central conductor application. Usually, it is limited to the search for discontinuities open to the surface such as fatigue cracks. Residual inspection permits the magnetizing of parts followed by the application of the magnetic particle media after the current is removed. When a central bar conductor is used, inspection of holes or bores is facilitated since inspection takes place after removal of the central bar conductor.

3.4.6.4.7.3.1.1 Currents used with the residual technique only need be great enough to magnetize the part sufficiently to show the type of discontinuity being sought. Some gross discontinuities may require only weak magnetization, and others, may require the maximum residual field obtainable. The residual magnetic field retained in a part is always less than the applied magnetic field strength that produced it. A maximum residual field strength results when the magnetization level within the part reaches magnetic saturation. Magnetizing currents greater than those needed to produce the maximum saturation field strength are of no value with the residual technique.

3.4.6.4.7.3.1.2 The residual method, in general, is reliable only for the detection of surface discontinuities. Since hard materials that have high retentivity are usually low in permeability, higher than usual magnetizing currents may be necessary to obtain a sufficiently high level of residual magnetism. The difference in the behavior between hard steels and soft steels is usually not very serious if only surface discontinuities are sought.

3.4.6.4.7.3.1.3 Inspector experience with typical discontinuities is very helpful to determine what current levels should be used to inspect a part using residual magnetism. In the absence of such experience, an inspector should first determine whether or not a part could be inspected using the residual approach. The part must be retentive enough so magnetic particle indications will be formed at any discontinuities in the part. Magnetizing the part in a coil with the maximum DC current available can make a rough determination of a part's retentivity. If after magnetization, the part will lift and hold an ordinary steel paper clip chances are good the part is retentive enough for residual inspection. If the part will not hold a paper clip, residual techniques may still be possible depending upon the nature of the discontinuities you expect to find. In this case, the inspector must test the part using the continuous technique, inspect for indications at possible weak areas, and then remove these indications and reapply the magnetic particle media to see if residual indications are produced. The current used to form the indications found with the continuous technique will give an inspector some indication of the current level needed for residual inspection.

3.4.6.4.7.3.1.4 The application of magnetic particle media for residual inspection is simply a matter of covering the area to be inspected. Care SHALL be taken with a liquid suspension to ensure the parts are adequately covered using low velocity streams or sprays, and the parts are positioned to take advantage of any particle flow resulting from drainage on the part surface. Some parts may need a longer drain time than others, since on smooth surfaces indications may be slower in forming. In some cases a formation of fine indications may be enhanced by immersing the magnetized part in liquid media for a considerable time. This permits time for the leakage fields to attract and hold the maximum number of particles resulting in an increase in sensitivity.

3.4.6.4.7.3.1.5 Care SHALL be taken when applying dry magnetic powders to magnetized parts to avoid getting too much powder on a part's surface and masking a discontinuity. A combination of a light blowing and tossing action is needed, either from a hand-held container or a pressurized powder blower. Additional care is also required when removing any excess powder from a surface so you will not hinder formation of indications or remove indications already formed. The use of dry powder with the residual technique has several disadvantages. It is more difficult to apply to interior surfaces of a part than is a liquid suspension and is more difficult to completely cover a part in a short time.

3.4.6.4.7.3.1.6 Spraying, flowing, or immersing the part into a tank may be used to apply liquid suspensions. Care is required on parts with smooth surfaces to avoid removing any indications by the rapid removal of a part from the bath when using the immersion technique. To ensure uniform concentration, the suspension SHALL be continuously agitated. The bath concentration SHALL be maintained within the manufacturer's specified limits, too weak a particle concentration will produce weak indications, and in borderline cases may cause fine discontinuities to go undetected. Also, too heavy a concentration produces heavy background accumulations that reduce contrast.

3.4.6.4.7.3.1.7 Most magnetic particle indications produced using the residual technique appear quickly on a part. Longer times are required when discontinuities are extremely fine. Holding the part in a position that will allow residual suspension drainage to flow across the suspected areas can sometimes speed up formation of the indications. In the case of a cylindrical part, hold it in a near vertical position allowing the drainage flow across circumferential (transverse) cracks.

3.4.6.4.7.3.1.8 One application method practiced, mostly on small parts, the parts are magnetized one at a time, and then placed in a tray and immersed in a tank containing an agitated bath of magnetic particles. These parts SHALL be placed in the tray so they do not touch each other or else non-relevant indications, known as magnetic writing ([Paragraph 3.5.5.2.1](#)), may be produced at the points of contact. Parts SHALL NOT be carelessly loaded into the basket for the immersion application. Both the concentration of the bath and the immersion time affect the production of indications. If the leakage field at the discontinuity is weak, prolonged immersion permits more particles to come into the influence of the field and makes the indication more visible.

3.4.6.4.7.3.1.9 Although the residual technique is not as widely used today as the continuous technique, it does have some advantages that make it attractive in some circumstances. The residual approach is capable of close control and provides uniform results to a greater degree than the continuous technique.

3.4.6.4.7.3.2 Continuous Application Technique. The continuous technique is used primarily with liquid suspensions, although occasionally dry powder is more appropriate. This technique requires the magnetizing force be present while the liquid suspension is being applied to the part in sufficient quantity for the particles to be highly mobile. When the current is on, the maximum flux density will be created in the part and the maximum flux leakage will be present at a discontinuity to attract the magnetic particles to form an indication. Leaving the current on for long periods of time is not practical or necessary in most instances. However, when using dry particles and either AC or HWDC as the magnetizing current, the current is sometimes kept on for minutes at a time. If allowed to flow for any appreciable time, the heavy current required for proper magnetization can cause overheating of parts and contact burning or damage to the equipment. In practice, the magnetizing current is normally on for only a fraction of a second at a time since the real requirement is a sufficient number of magnetic particles have been applied to the area of interest. These particles SHALL be free to move while the magnetizing current flows. The bath ingredients are selected and formulated to enable particles to move through the film of liquid on the surface of the part and form strong, readable indications. This is one of the reasons why the viscosity and concentration of the bath are so important.

3.4.6.4.7.3.2.1 The reason for the greater sensitivity of the continuous method is simple. When the magnetizing force is applied to a ferromagnetic part, the flux density rises. Its intensity is derived from the strength of the magnetizing force and the material permeability. When the magnetizing force is removed, the residual magnetism in the part is always less than the field present while the magnetizing force was active. The key difference depends on the retentivity of the material being magnetized. Consequently, the continuous technique, for a given value of magnetizing current, will always be more sensitive than the residual technique. Procedures have been developed for the continuous technique which make it faster than the residual technique because the indication is being formed at the time the current is being applied, plus the added time for indications to build-up allowing particles to build-up while being immersed. The indication is produced during current application and the sixty-second migration of the magnetic particles as the excess vehicle drains from the part. Parts made of low retentivity materials, such as low carbon steel, SHALL be inspected using the continuous technique; since residual leakage fields at discontinuities in these materials are too weak to produce good magnetic particle indications.

3.4.6.4.7.3.2.2 The continuous technique is the only effective technique to use on low carbon steels or on iron having little retentivity. It is frequently used with AC on such materials because the alternating current field produces excellent mobility of the particles. With the wet technique, the usual practice is to flood the surface of the part with the bath, then simultaneously terminate bath application and momentarily apply the magnetizing current. Thus the magnetizing force acts on the particles in the film of the bath as they are draining over the surface. Strength of the particle bath has been standardized to supply a sufficient number of particles in the film to produce good indications with this technique.

NOTE

The continuous technique requires more attention and alertness on the part of the inspector than does the residual method. Careless handling of the bath/current application sequence can seriously interfere with reliable results.

3.4.6.4.7.3.2.3 Probably the highest possible sensitivity obtainable for very fine defects is achieved by immersing the part in the wet bath, magnetizing the part for a short time while immersed, and continuing to magnetize while the part is removed from the bath and while the bath drains from the surface.

3.4.6.4.7.3.2.4 Wet suspensions are primarily used with the continuous technique, with the exception being when small, subsurface defects must be found. Under some conditions, a dry particle continuous technique can produce slightly greater sensitivity. Timing of the liquid suspension application and the magnetizing current is critical to form good indications. The area of the part to be inspected SHALL be completely flooded with suspension and then the current SHALL be applied at least twice in rapid succession. Turning off or diverting the suspension flow before the final application of current ensures the force of the flow will not interfere with the formation of indications. Extra care SHALL be taken with parts having low re-ventivity to minimize the risk of washing away an indication. On larger parts where the entire area of interest cannot all be flooded simultaneously, additional "shots" of current SHALL be applied immediately after the suspension application hose is moved away from each point of application. If the equipment duty cycle permits, one or two additional current applications may be applied just before stopping the bath to help form small indications.

3.4.6.4.7.3.2.5 It should be noted, the continuous technique requires more attention and alertness on the part of the inspector than does the residual. Careless handling of the suspension or applying the current application sequence may seriously interfere with the results. Normally, the duration of the magnetizing shots will vary from one-half-second to 2- seconds, depending on the difficulty involved in showing the condition of interest. In some instances, when large forgings or steel castings are to be inspected with manual suspension application, the magnetizing current may be left on from 5 to 10- seconds, during which time the part may be repeatedly swept with the suspension spray. The magnetizing field is maintained for a second or two after the final spray has ceased or been diverted.

3.4.7 Wet Fluorescent Inspection Technique.

3.4.7.1 General. When exposed to near ultraviolet light (UV-A), fluorescent magnetic particles emit a highly visible yellow-green color. Indications produced are easily seen, and the fluorescent particles give much stronger indications of very small discontinuities than do the non-fluorescent magnetic particles. The differences between the wet visible technique and the wet fluorescent technique are comparatively minor regarding suspension characteristics, maintenance, and application, as well as the inspection variables and demagnetization techniques. The following applies only to the wet fluorescent technique.

3.4.7.2 Advantages and Limitations. Fluorescent particles have one major advantage over the untreated or visible particles. That is their ability to give off a brilliant glow under UV-A illumination. This brilliant glow serves three principal purposes:

- In semi- or complete darkness, even very minute amounts of the fluorescent particles are easily seen, having the effect of increasing the apparent sensitivity of the process, even though magnetically, the fluorescent particles are not superior to the uncolored particles.
- Even on discontinuities large enough to give good visible indications, fluorescent indications are easier to see and the chance of the inspector missing an indication is reduced; even when the speed of inspecting parts is increased.
- Concurrent with the greater visibility of indications formed by fluorescent particles, the background caused by excessive magnetization is also more severe. Consequently, greater care SHALL be exercised in selection of the particle concentrations and magnetization levels for the inspection with fluorescent particles.

3.4.7.2.1 In most applications, the fluorescent particle technique is faster, more reliable, and more sensitive to very fine defects than the visible colored particle technique. Indications are easier to detect, especially in high volume testing. In addition, the fluorescent technique has all the other advantages possessed by the wet visible suspension technique.

3.4.7.2.2 The wet fluorescent technique also shares the disadvantages found with the wet visible technique. In addition, there is a requirement for both a source of UV-A and an inspection area from which the white light can be excluded. Experience has shown these added requirements are more than justified by the gains in reliability and sensitivity.

3.4.7.3 Inspection Materials. There is no difference in vehicle requirements between the fluorescent and non-fluorescent materials. Petroleum distillates SHALL meet the same specifications as listed in [Table 3-1](#), with one additional requirement, the vehicle itself SHALL NOT strongly fluoresce.

3.4.7.3.1 The particles used in the wet fluorescent technique are magnetically the same as the visible type, but they carry a fluorescent dye and the binding material that holds the dye and particle together as a unit. This coating could make the particles less effective in producing indications. However, fluorescent particle indications require only a small fraction of the particles to be easily visible as compared to the non-fluorescent type. Thus, the overall effect is a significant increase in sensitivity.

3.4.7.3.2 Fluorescent particles are supplied primarily as a dry concentrate, incorporating all the ingredients necessary for use in oil or water, as appropriate.

3.4.7.3.3 It is important the bond between the fluorescent dye or pigment and the magnetic particle is able to resist the vigorous agitation received in the circulation pump and the solvent attack from the suspension fluid. If the dye separates from the magnetic particle, the dye tends to cling to the surfaces of the part, independent of any magnetic attraction, thus increasing the background against which indications must be viewed. At the same time, the magnetic particles held magnetically at indications have lost some or all of their fluorescing ability, reducing their visibility.

3.4.7.3.4 The need to provide successful magnetic particle testing under varying conditions has resulted in the development of different materials. These fluorescent materials are readily available in a dry concentrate powder form suitable for use in water and/or oil suspensions. Prepared oil-based baths are also available in aerosol-type cans and bulk quantities.

3.4.8 Portable Magnetic Particle Inspection.

3.4.8.1 Capabilities and Limitations of Portable Inspection. Sometimes, it may not be feasible to bring a part to the laboratory for inspection, thus the inspector must travel to the part. In these cases, mobile ([Paragraph 3.3.2.2](#)) and portable equipment ([Paragraph 3.3.2.3](#)) SHALL be used to conduct the inspection.

3.4.8.1.1 Portable induced field inspection equipment generally refers to a power pack or a probe (yoke). Magnetic power packs, probes, and yokes are small and easily portable. The terms probe and yoke are synonymous, and differ only due to manufacturer's nomenclature. This category of inspection equipment is described here in conjunction with the techniques for their use and application.

3.4.8.1.2 This equipment is easy to use and adequate when testing small castings or machine parts for surface cracks and weld inspection. They induce a strong magnetic field into that portion of a part that lies between the poles or legs of the yoke. The induced field flows from one leg of the yoke to the other regardless of the style or leg configuration. Yokes or probes are available with either fixed or articulated legs.

3.4.8.1.3 Either dry powder or wet magnetic particles may be used in conjunction with a yoke for the detection of discontinuities. Yokes are available for operation from a 115-volt, 60-hertz AC outlet, or from a 12-volt DC battery. A permanent magnet yoke is also available, permitting inspections to be performed without the use of electric current.

3.4.8.1.4 The units are designed for simplicity, ease of handling, and one-person operation. They may be used on machine-finished surfaces, as well as castings and weldments fabricated in a variety of configurations. The units induce a strong magnetic field at the surface of the part being inspected. Since no current is flowing through the part being subjected to inspection it is impossible to overheat or burn the part. The flexibility of a yoke with articulating legs is greatly increased permitting inspections to be performed on parts of varied configurations.

3.4.8.1.5 Yokes or probes are limited to the detection of surface and near surface discontinuities only. They SHOULD NOT be used for deep-seated, subsurface discontinuities due to the limited penetration of the induced magnetic field. Because of their size, they cannot be used with a 100-percent duty cycle. Rather, they are limited essentially to spot-checking and occasional sample testing rather than continuous production testing. Under optimum operating conditions, the fixed leg yoke has a limited inspection area governed by the distance between and immediately surrounding the legs. The moveable or articulated leg yoke can inspect either a larger area (legs apart) or detect finer discontinuities by concentrating the magnetic field in a smaller area (legs closer together).

3.4.8.2 Portable Equipment Current Capabilities. Both AC and DC current can be used for electromagnetic yokes. Under certain circumstances, it is even possible to use a strong magnet to produce a field. The design of a yoke will help determine the type current it is capable of producing.

3.4.8.2.1 Alternating Current (AC). An alternating current magnetizing field induced in a part concentrates at the surface layers of the material and produces a surface longitudinal field. AC provides a very desirable and useful field. Polarity reversal at the 60-hertz rate produces a noticeable surge peak reflected in the magnetic field. Eddy currents are a by-product of AC, which tend to guide the field basically between the poles. The vibratory action of AC adds significantly to the magnetic particle mobility enhancing the formation and build-up of larger and sharper indications at discontinuities. Yokes magnetizing with AC can be readily used for demagnetizing. Because of the reversing nature of AC, the residual method of inspection cannot be used when AC is used for magnetism.

3.4.8.2.2 Direct Current (DC). Direct current provides a constant, strong magnetic field. Magnetic particle mobility is minimal and the gathering of magnetic particles at a discontinuity is quite difficult because the vibratory action of an AC field is missing. Direct current induced fields can be successfully applied to small parts. Surface and near subsurface defects can be revealed. The residual method of inspection may be used with direct current, but alternating current SHALL be used for demagnetizing.

3.4.8.2.3 Pulsed Direct Current. Pulsed direct current combines the strong magnetic field of direct current; with the particle mobility of alternating current. Pulsed direct current is produced by rectifying single-phase alternating current. This pulsating direct current pulses at a rate and level to produce a noticeable surge peak in addition to providing the necessary vibratory action for magnetic particle mobility. Though pulsed, the direct current aspect permits the residual method of inspection to be used.

3.4.8.2.4 Permanent Magnet. When permanent magnets are placed on a ferromagnetic surface, the magnetic field travels through the surface from one pole to the other. The flux field will be relatively straight along a line between the poles and strongest near the poles. Field strength will vary and be weakest at a point midway between the poles. The actual field strength at any point will depend upon the strength of the magnet and the distance between the poles.

3.4.8.3 Field Direction. Regardless of the current selected (AC or DC), or the position of the legs, the magnetic flux field induced in a test surface always traverses a path in the same direction from one pole or leg to the other. The yoke is therefore oriented in a transverse direction to the discontinuities being sought to obtain optimum results.

3.4.8.4 Selection of Application Method and Particles. The type of magnetic particles to be used boils down to two choices: application with the dry or wet method, and choose from the various colors available, including fluorescent colors.

3.4.8.4.1 Dry Powder or Wet Suspension Selection. As in all other cases of magnetic inspection, it is possible to use both dry and wet application methods during portable inspection. Portable inspection is commonly accomplished with aerosol cans containing wet/fluorescent particles, but small shakers are available to apply the dry powder. The decision for selecting an application technique is influenced principally by the following considerations:

3.4.8.4.1.1 Size/Location of the discontinuity. Dry powder is excellent for surface defects of moderate size. The wet method is usually best for very fine and shallow defects.

3.4.8.4.1.2 Convenience. The wet technique offers the advantage of easy, complete coverage of the part surface of all sizes and shapes. Dry powder is more often used for localized inspections.

3.4.8.4.2 Color Selection. Selection of the color of particles to use is essentially a matter of securing the best possible contrast with the background of the part surface being inspected. The differences in visibility among the black, gray, red, and yellow particles are considerable on backgrounds that may be dark or bright, and when viewed in various kinds of light may be difficult to see. If some difficulty is experienced in seeing indications, the inspector should try a different color of powder. For the wet technique, the best visibility and contrast is obtained by the use of fluorescent particles. The wet/fluorescent technique supplied with an aerosol can has been used in constantly increasing numbers of inspection applications for many years, principally because of the ease of seeing even the faintest indications.

3.4.8.5 Application of Current and Particles during Portable Inspection. Magnetic particles may be applied either dry or in a liquid suspension. The part may be magnetized first and the particles applied after the magnetizing force is removed (residual method, applicable to DC or specially designed AC units only), or the particles may be applied while the magnetiz-

ing force is being applied (continuous method of inspection). In order to select the proper variations to obtain optimum results, the inspector must understand the variations and how each affects the desired end result.

3.4.8.6 Portable Inspection Applications. Hand-held yokes are versatile, general-purpose magnetic particle test equipment because of their compact size, low voltage requirements, and minimal weight. They may be used at an inspection facility where parts are brought for inspection, or they may be taken to the inspection site. They are used to test large castings and weldments, assembled and welded structures, or component parts of assemblies without the necessity of disassembly. Yokes are used on parts subject to arc burns, to detect surface cracks in welds and castings, and to locate fatigue cracks of large assemblies that may not be conveniently inspected with either mobile or stationary equipment. Where no source of electric current is available, or because of fire or explosive hazard, the use of electric current is not permitted; a permanent magnet yoke can be used for inspection. One typical application of a probe/yoke is shown ([Figure 3-28](#)). The yokes SHALL be able to pass the dead weight checks in TO 33B-1-2 WP 103 00.

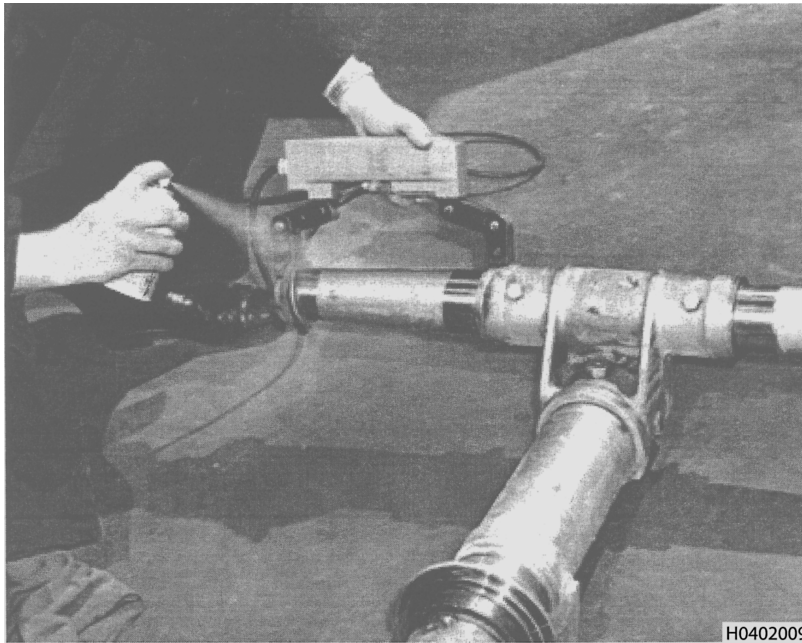


Figure 3-28. Field Inspection of Nose Wheel Strut

3.4.9 Special Magnetization Techniques. Many parts require specialized techniques to obtain a good magnetic particle inspection, because of their small L/D ratio, shape, complicated geometry, or the location and kind of discontinuities. Some of these techniques are: "Induced Current," "Slurry," "Mag Rubber" and Multi-directional techniques.

3.4.9.1 Induced Current Magnetization. This technique uses the fields generated by induced currents in a part, which are produced by rapidly varying longitudinal fields. Induced current magnetization is used for the detection of circumferential defects in rings, discs, and cylinders. A varying magnetic field in any conducting metal generates electrical current in that metal. Increasing the length of the current path can reduce the amplitude of the current. Therefore, a cut, an insulated joint, or a deep surface indentation causes the current path to increase around the discontinuity. The amplitude will also depend on:

- The size and shape of the cross section through which the magnetic field varies.
- The rate of variation in flux lines per second.
- The electrical conductivity of the metal.

3.4.9.1.1 When the magnetic field strength is changing, the induced current will flow through in the part, at right angles to the magnetic field. When the magnetic field varies continuously, as it does in the case of alternating or half-wave DC fields,

a succession of induced current pulses are produced. These induced current pulses are often referred to as eddy currents. The process of inducing high amplitude eddy currents in a part to be inspected can also introduce stray eddy currents in adjacent metallic components. The effect of stray eddy currents in a metal is twofold. First, heat is generated whenever an electric current flows in a conductor because of resistance. The generation of such heat is of little consequence in magnetic particle inspection because of the relatively short duration of the current flows. The second effect of stray eddy currents is important in magnetic inspection. The magnetic fields resulting from the stray eddy currents is in opposition to the magnetic fields which produce them, resulting in either a reduction of the amplitude of inducing alternating magnetic fields or a decrease in decay rate for an inducing field generated by a collapsing DC current. Either condition results in a reduction in amplitude of the induced current in the part to be inspected. Precautions SHALL be taken to minimize the generation of any induced stray eddy currents within metals in contact with, or in the immediate vicinity of the part to be inspected. Any pole pieces should be made of laminated silicon transformer steel or low carbon steel with a low magnetic retentivity. Any part, supports, or contact plates should be split or cut partially through in such a manner as to produce as long a current path as practical. In addition to being split, some part supports are made of nonmagnetic metals such as brass or stainless steel, which are also poor electrical conductors. This also reduces the stray eddy currents generated in them.

3.4.9.2 Advantages of Induced Current Magnetization. The advantages of using the induced current method are:

- No current contact need be made on a part.
- Strong fields are generated in a part by the induced currents.
- Parts with L/D ratios of less than one can be inspected without the need for extremely high coil currents.

3.4.9.3 Induced Current Magnetization Technique. Induced current techniques require the part be circular in shape and have no deep radial cuts or slits which would prevent the generation of an induced current through the part. It is the circular field produced by such an induced current that generates the leakage fields at circumferential discontinuities. Circumferential discontinuities, in order to be detected using the induced current method, must be at or very near the surface of a part. The circular magnetic fields generated by induced currents tend to be crowded toward an outer surface. Circular, disc, or cylindrically-shaped parts, which are retentive, may be inspected residually using a single pulse of induced current; such as obtained when DC current in a coil is suddenly interrupted allowing the coil field to rapidly collapse to zero. Parts having a low retentivity SHALL be inspected using the continuous method and AC or half-wave DC current in the coil. The repetitively induced current pulses generated by each cycle of these currents is responsible for the formation of the indications at discontinuities. For parts with smooth surfaces, care is required when handling the parts after inspection to prevent mechanical loss of the indications. Washing action is much less of a problem with parts having rougher surfaces, as both mechanical and magnetic bonds hold indications.

3.4.9.3.1 Parts to be inspected using the induced current method must be positioned with their axis parallel to the coil, or coils. Two coils, one on each side of a part, may be used when the part's diameter is larger than the coils. The coils in this case must be connected electrically; assuring that the coil fields will be in the same direction through the central region of the part. If the part is retentive and is to be inspected residually, DC current is used in the coil. The power pack supplying the DC to the coil must have quick-break electrical circuitry to obtain a rapid collapse of the coil field. Alternating or half-wave DC current must be used in the coil with the continuous technique when a steel part has a low retentivity.

3.4.9.3.2 The longitudinal flux density in a part and the rate of decay or collapse of this flux determines the magnitude of the induced current generated in the part. The higher the coil amperage, the higher the coil field strength and the flux density in a part, up to a coil amperage that produces magnetic saturation in the part. The flux density, and thus the induced currents in short cylinders having an L/D ratio of less than 3 or 4, can be increased by placing the part between two laminated pole pieces while being magnetized. Placing a laminated core or pole piece in the ring while it is being magnetized can increase induced currents in ring-shaped parts, such as bearing races. The laminated core in this case increases the total flux threading the ring. Remember when using the induced current technique, any means used to increase the flux in the direction of the coil field through the part will increase the magnitude of the induced currents, up to the point of magnetic saturation.

3.4.9.3.3 Placing a laminated core centered against each side of a disc can increase magnetic flux through the center region of disc-shaped parts. Another variation for the use of a laminated core is in the inspection of holes in large parts suspected of having circumferential discontinuities. In this case, the magnetizing coil is placed around one end of the core and the other end is used as a probe for placement in the hole. Alternating current is used to energize the coil. In operation the core is placed in a hole, liquid magnetic particle media is sprayed around the inside surfaces of the hole, and while the coil is ener-

gized. Before withdrawing the core from the hole, the coil is de-energized so as not to demagnetize the area around the hole. When demagnetization of the area is required, the core is simply removed from the hole while the AC current is flowing.

3.4.9.4 Selection of Induced Current Level. No "rule-of-thumb" formulas have been developed for the induced current method of magnetization. Lacking any other information upon which to select a current level, the "rule-of-thumb" formulas given in [Paragraph 3.7.1](#) may be used to obtain trial amperages for parts having L/D ratios up to 15. Part diameters, which approach or are greater than the coil and are very short in length (e.g., disc-shaped parts), will usually require laminated cores to be used, so the rule-of-thumb coil formulas are not applicable. The formulas were developed for the determination of coil amperages, which will produce a longitudinal flux density in a part of 70,000 lines per square inch. The rate of change or rate of collapse of this longitudinal flux produces an induced current in the part, which in turn results in leakage fields at the discontinuities.

3.4.9.4.1 Magnetic Slurry. This specialized technique uses magnetic flakes in viscous slurry, taking advantage of the difference in light reflection from flakes reoriented by leakage fields at discontinuities. The slurry, being a viscous liquid applied by brush, has the advantage over dry powder of eliminating any hazard to adjacent equipment by airborne magnetic particles. Another advantage is the slurry can be applied and used successfully on vertical or overhead surfaces, on wet (even underwater) or dry surfaces, and over scaly, plated, or painted surfaces if the coatings are not too thick.

3.4.9.4.1.1 A magnetic particle testing material is available that supplements both wet and dry magnetic particle testing materials. This material formulation uses selected magnetic particles dispersed in a viscous, oily vehicle which results in slurry having the consistency of paint. The material is brushed on a surface to be inspected until the magnetic particles are evenly and thoroughly distributed. A magnetic field is generated in the test part through conventional AC or half-wave DC magnetizing techniques. Any discontinuities show up as contrasting black indications on a gray background. Alternating current fields using a yoke or probe are capable of revealing very fine surface discontinuities using this slurry technique.

3.4.9.4.1.2 The slurry concentration can be varied to suit particular inspection requirements. The material is brushed evenly on a part, much as paint would be, prior to magnetization of the part. If required, the material can be brushed repeatedly permitting magnetization in various directions. The oily vehicle used in the slurry mixture is nondrying, and the slurry can be removed using dry rags, paper towels, or prepared cleaning solvents.

3.4.9.5 Magnetic Rubber. This technique uses a diluted silicone rubber containing black magnetic particles for the inspection of the interior or otherwise difficult to view surfaces. Additionally, it is the most sensitive of all magnetic particle techniques for detecting the smallest possible surface cracks on any surface. Its use is limited by the high labor requirement. The liquid rubber is catalyzed, placed against the surface to be inspected, and held in place with the appropriate dams and fixtures. Applied magnetic fields cause the particles to migrate to defect locations while the rubber cures. After curing, the rubber material which has formed a replica of the surface against which it was placed, is viewed under low power magnification for the indications formed during the inspection.

3.4.9.5.1 Magnetic rubber formulations using finely divided magnetic particles in a silicone rubber base are used for the inspection of holes and other surfaces not easily accessible. The liquid silicone rubber mixture is poured into holes or against the surface of the magnetic parts to be inspected. Curing time for silicone rubbers varies from about 10 to 30-minutes, depending upon the particular silicone rubber, the catalyst, and the amount of catalyst used to produce the curing reaction.

3.4.9.5.2 While the rubber cures, the surface inspected must stay in the required magnetized state. This can be accomplished using a permanent magnet, a direct current yoke, an electromagnet, or some other suitable means. Whatever method of magnetization is used, the leakage fields at any discontinuities on the surfaces inspected must be maintained long enough to attract and hold in position the magnetic particles until a partial cure takes place. A two-step magnetizing procedure has been developed: 1) The first magnetization is accomplished for a short time in one direction, 2) followed by a second at 90-degrees to the first for the same length of time. This procedure SHALL be repeated for whatever period of time is needed until the cure prevents particle mobility. Magnetization in two directions 90-degrees apart assures formation of indications at discontinuities in all directions.

3.4.9.5.3 After curing, the rubber plugs which are exact replicas of the surfaces, are removed and visually examined for indications, which will appear as black lines against the gray or yellow background of the silicone rubber. Examination of the replicas is usually done with magnification, and often with a microscope when the goal of the inspection is to detect the smallest possible cracks. Location of any discontinuities or other surface imperfections can be determined from the location of the indications on the plugs.

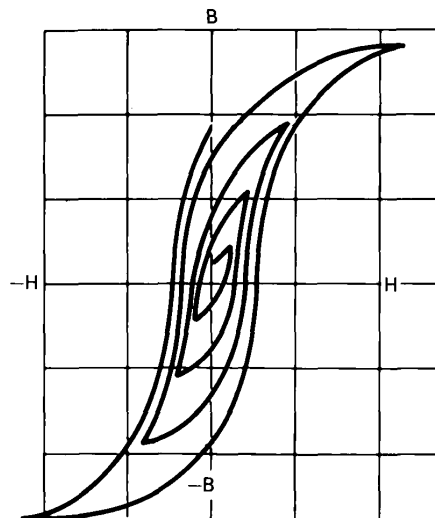
3.4.10 **Multidirectional Magnetization.** Multidirectional magnetization can be very effective in detecting randomly oriented discontinuities quickly. The technique energizes two or more magnetizing circuits in different directions very rapidly (almost simultaneously) resulting in a reduction of testing time and part handling.

3.4.11 **Demagnetization.** Any ferromagnetic material subjected to magnetic particle inspection requires demagnetization. When performing magnetic particle inspection of aircraft parts, it is essential to demagnetize them. The inspector SHALL understand the reasons for this step, as well as the problems involved and the available means for solving them.

3.4.11.1 **Purpose of Demagnetization.** Ferromagnetic materials retain a certain amount of residual magnetism (or remnant field) after application of a magnetizing force. This does not affect the mechanical properties of the part. However, a residual field can impede the operation of some parts, as well as, affect the operation of adjacent equipment sensitive to low level stray magnetic fields.

3.4.11.2 **Principles of Demagnetization.** Demagnetization may be accomplished in a number of different ways. The technique used depends upon the electrical power and equipment available, the degree of demagnetization required, and the skill of the inspector.

3.4.11.2.1 One of the simpler techniques subjects the magnetized part to a magnetizing force that continually reverses its direction. At the same time, this force is gradually decreased in strength. As the decreasing magnetizing force is applied, first in one direction and then the opposite direction, the magnetization of the part is decreased. This decreasing magnetization is accomplished by smaller and smaller hysteresis loops created by the application of decreasing current as shown (Figure 3-29). The smaller the hysteresis loop produced the more demagnetization accomplished.



H0402010

Figure 3-29. Hysteresis Loops Produced During Demagnetization

3.4.11.2.2 For all practical purposes, the only way to completely demagnetize a part is by heating it to its Curie point (Paragraph 3.4.11.6.1) or above. This SHALL NOT be attempted without engineering direction due to the risk of damaging the part.

3.4.11.2.3 Under normal conditions, a part is considered satisfactorily demagnetized if the magnetic field is at or below 3 units on a gauss meter or 2 units on a field indicator.

3.4.11.3 Requirements for Demagnetization. Ferromagnetic aircraft parts require demagnetization principally to prevent magnetic flux from affecting instrumentation. There are several additional reasons supporting the requirement for demagnetization.

3.4.11.4 Situations Requiring Demagnetization. Demagnetization is required when the residual field in a part:

- Aircraft components are required to be demagnetized after inspection unless specified otherwise.
- May interfere with subsequent machining operations by causing chips to adhere to the part surface, or the tip of a tool to become magnetized from contact with the magnetized part. Such chips can interfere with smooth cutting by the tool, adversely affecting both part surface finish and tool life.
- May interfere with electric arc or electron beam welding operations. Residual magnetic fields may deflect the arc or electron beam away from the point at which it should be applied.
- May interfere with the functioning of the part itself after it is placed into service. Magnetized tools (e.g., milling cutters, hobs, etc.) will hold chips and cause rough surfaces, and may even be broken by chips adhering to the cutting edge.
- Might cause trouble on moving parts, especially those running in oil, by holding particles of metal or magnetic testing particles - for instance, on balls or races of ball bearings, or on gear teeth.
- May prevent proper cleaning of the part after inspection by magnetically holding particles to the part surface.
- May interfere with subsequent magnetization requirements.
- May hold particles that interfere with later applications of coatings such as plating or paint.

3.4.11.5 Situations Not Requiring Demagnetization. Demagnetization is not usually required when:

- The parts are not aircraft parts and have low retentivity. In this case, the residual field is low or disappears after the magnetizing force is no longer acting. An example is low-carbon plate such as used for low strength weldments, tanks, etc.
- The material in question consists of non-aircraft structural parts such as weldments, large castings, boilers, etc., where the presence of a residual field would have no effect on other components or the proper service performance of the part.
- If the part is to be subsequently processed or heat-treated, and in the process will become heated above the Curie point, or about 770°C (about 1418°F). Above this temperature, steels become nonmagnetic, and completely demagnetized on cooling when they pass through the reverse transformation.
- The part will become magnetized anyway during a subsequent process, for example, when held in a magnetic chuck.
- A part is to be subsequently magnetized in another direction to the same or higher level at which it was originally magnetized, for example, between circular and longitudinal magnetization for magnetic particle inspection.
- The magnetic field contained in a non-aircraft finished part is such there are no external leakage fields measurable by ordinary means (e.g., the field produced during magnetic particle inspection with circular magnetization).

3.4.11.5.1 A residual magnetic field in a ferromagnetic material exists because there is a preferred orientation of the magnetic domains caused by a previously applied magnetic field. A residual magnetic field perpendicular to a previously established residual field can only be produced by application of a magnetic field in the perpendicular direction strong enough to rotate the domain 90-degrees. Because the preferred orientation of the domains has been rotated 90-degrees, the previous residual field no longer exists. For this reason, longitudinal magnetization, strong enough to produce indications of discontinuities in a part that previously had a residual circular magnetic field, reduces the circular residual field to zero. If the magnetizing force is not of sufficient strength to establish the longitudinal field, the strength SHALL be increased or

other steps taken to ensure a residual longitudinal field actually has been established. For example, a large part having a large L/D ratio may require multiple longitudinal shots along its length to eliminate the circular field. Rotation of the preferred orientation of the magnetic domains also occurs when a circular residual field is produced in a part with an existing residual longitudinal field.

3.4.11.5.2 If the two fields, longitudinal and circular, are applied simultaneously, an applied field results that is a vector combination of the two in both strength and direction. If the magnitude of the resultant applied field is large enough, then a residual field will be produced in this same direction. If, however, the fields are induced sequentially the last field applied, if strong enough to produce a residual field, will eliminate the residual field from the previous magnetization. A convenient method of assuring reduction of a residual magnetic field in one direction and establishing a field in a perpendicular direction is to slightly increase the magnetizing force of the second shot.

3.4.11.6 Demagnetization Limitations.

NOTE

Complete demagnetization is not possible even though it is often specified.

3.4.11.6.1 Curie Point. When steel is heated, it passes through its Curie point, approximately 770°C (or about 1418°F) for soft steels. Above the Curie point it is no longer ferromagnetic. When the steel cools to room temperature in the absence of a magnetic field, it will contain no residual magnetism. Other means of demagnetization always leave some residual field.

3.4.11.6.2 Earth's Magnetic Field. The earth's magnetic field can contribute to the difficulty of demagnetizing parts. A long part to be demagnetized SHOULD be placed so its principal axis is in an east-west direction. A long part lying in a north-south direction can never be demagnetized below the level of the earth's field. Rotating the part or structure on its east-west axis while demagnetizing often helps reduce the field in transverse members not lying east-west. Vibration of the structure during the demagnetization process is also helpful under these circumstances. Complete removal of all magnetic fields is virtually impossible.

3.4.11.6.2.1 The earth's field will always affect the residual magnetism in a ferromagnetic part and will often determine the lower limit of practical demagnetization. Long parts or assemblies of long parts, such as welded tubular structures, are especially likely to remain magnetized at a level determined by the earth's field, in spite of the most careful demagnetizing technique.

3.4.11.6.2.2 Many articles and parts become quite strongly magnetized from the earth's field alone. Transporting parts from one location to another may produce this effect. Long bars, demagnetized at the point of testing, have been found magnetized when delivered to the point of use. It is not unusual to find parts of aircraft, automotive engines, railroad locomotives, or any parts made from steel of fair retentivity are quite strongly magnetized after having been in service for some time, even though they may never have been near any artificially produced magnetic field. Parts also become magnetized by being near electric lines carrying heavy currents, or some form of magnetic equipment.

3.4.11.7 Demagnetization Methods.

3.4.11.7.1 General. Alternating and direct currents are used in demagnetizing aircraft parts after magnetic particle inspection. Although direct current can be used for demagnetization, alternating current demagnetization has been found to be more convenient. Since alternating current does not penetrate very deeply below the surface of magnetic materials, some parts may be difficult to demagnetize completely using alternating current. This is particularly true with large heavy parts, and may also be the case with parts of unusual shape. Direct current can be used to demagnetize if there is provision for current decay or reduction and a means for reversing the direction of the current. Demagnetization accomplished in this manner with direct current is the most complete and effective possible.

3.4.11.7.1.1 To demagnetize with direct current, the part is placed in a coil connected to a source of direct current. The current is adjusted to a value at least as great as that used to magnetize the part and a shot of current is given at this initial value. The direction of the current is then reversed, the value reduced, and a shot of current given at the new value. This process of reversing and reducing the current is continued until a very low value is reached. The part is now effectively demagnetized.

3.4.11.7.1.2 Parts with a circular field do not have magnetic poles. This lack of measurable poles, providing there are no discontinuities present, makes it impossible to check the magnitude of residual circular magnetization with the conventional residual field indicator. A common and recommended practice on aircraft parts is to magnetize the part longitudinally after it has been circularly magnetized. The difficult to measure circular field is then replaced by an easy to measure longitudinal field.

3.4.11.7.2 AC Demagnetization.

3.4.11.7.2.1 AC Tunnel Coil. The most common and convenient method of demagnetizing small to moderate sized parts is by passing them through an open tunnel-type coil through which alternating current at line frequency (usually 50 to 60-hertz) is passing. Another practice is to pass the 50 or 60-hertz AC through a coil with the part inside the coil, and gradually reduce the current to zero. In the first case, the reduction of the strength of the reversing field is obtained by withdrawal of the part axially from the coil (or the coil from the part) and for some distance beyond the end of the coil (or part) along that axial line. In the second case, the gradual decay of the current in the coil accomplishes the same results. This method of demagnetization is particularly suitable for large numbers of relatively small parts.

3.4.11.7.2.2 Stationary MPI Bench. Stationary magnetic particle testing equipment often has demagnetization capabilities. If so equipped, AC current may be passed directly through the part or through the coil on the magnetizing unit. For demagnetization of parts, the alternating current is reduced to zero automatically by built-in means of step-down switches or variable transformers for older equipment, or solid-state devices for newer equipment. The step-down feature permits the demagnetization of parts without removal from the magnetizing equipment. This procedure is more effective on long, circularly magnetized parts than the separate coil method, but does not overcome the lack of penetration due to skin effect unless frequencies much lower than 60-hertz are used.

3.4.11.7.3 DC Demagnetization.

3.4.11.7.3.1 Stationary MPI Bench. Demagnetizing by the direct current reversing step-down feature is essentially identical in principle to the AC method, but is more effective on parts with heavy cross sections. Modern stationary DC magnetizing equipment usually incorporates this capability. The use of DC current permits a more even and complete penetration of even large cross sections. The DC current flows in one direction for a short time, it then is slightly reduced in magnitude and completely reversed in direction. The process of automatically reversing and reducing the current is continued until the current reaches zero and the part is effectively demagnetized. This method of demagnetizing is especially effective in removing circular fields when the current can be passed through the part and works well with a central conductor, when applicable. Small parts can be placed in a standard coil and larger parts can be cable-wrapped for their full-length, as induction loss is not present with DC.

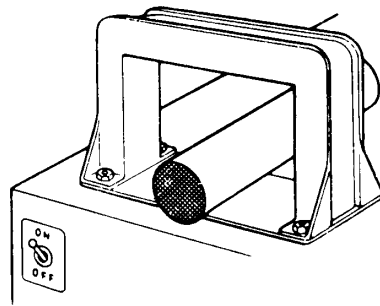
3.4.11.8 Demagnetization Procedures.

NOTE

It is important to remember the part SHALL be completely withdrawn from the magnetic field of the coil before the current is shut off.

3.4.11.8.1 Demagnetizing Coil. The most common type of stationary demagnetizing equipment consists of an open coil through which alternating current at line frequency, usually 50 to 60-hertz is used. The demagnetizing coil may be equipped with a stand or may be constructed and placed on a bench. Larger coil sizes have a track or carriage on which parts can be placed to facilitate handling.

3.4.11.8.1.1 To use a demagnetizing coil such as illustrated ([Figure 3-30](#)), the part is placed in the coil and the current turned on. While the current remains on, the part SHALL be slowly withdrawn from the yoke a distance of 4 to 5-feet before the current is shut off. The axis of the part SHOULD be parallel to the axis of the yoke for regularly shaped parts. On complex parts, more complete demagnetization is sometimes possible if the part is rotated and turned end for end. For best results, the diameter of the demagnetizer yoke SHOULD be just large enough to accommodate the part. However, for practical purposes one or two yoke sizes will satisfactorily serve an inspection facility. To demagnetize small parts in a large coil, place the parts close to the inside wall or corner of the yoke since the demagnetizing forces are strongest in that area.



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Figure 3-30. Part in Demagnetizing Coil

3.4.11.8.2 Demagnetizing with Stationary Equipment. Magnetic particle inspection equipment that magnetizes with AC or DC is used to demagnetize parts after inspection, depending upon the demagnetization features included in the equipment and the size and shape of the part.

3.4.11.8.2.1 Step-Down Demagnetization.

CAUTION

Care SHALL be used when demagnetizing small parts using machines equipped with “step-down” demagnetizers, which do not have adjustable current tap switches. A small part such as a bolt being circularly demagnetized with this equipment may be overheated by the initial high current steps.

3.4.11.8.2.1.1 Some stationary AC equipment has a coil on rails and a toggle switch, which enables the inspector to turn the current on in the coil, and leave it on. This coil then becomes a demagnetization coil when a part is drawn through it while the current is flowing.

3.4.11.8.2.1.2 This same equipment may also have a rheostat or current control switch enabling the inspector to select different magnetizing current levels as well as initial demagnetizing current levels. These switches may be motor driven. When equipment with a motor driven switch is used for demagnetization, the inspector places the part in the equipment and presses the demagnetization switch, this causes the motor to drive the switch contactor from maximum to minimum current positions, giving a shot at each successively lower current value. This effectively demagnetizes the part and can be used either by passing the current through the coil on the equipment (longitudinal demagnetization), or by passing the current through the part itself (circular demagnetization). This process is referred to as “step-down” demagnetization.

3.4.11.8.2.1.3 A step-down reversing DC demagnetization is usually completed in about 30-seconds; one-second per step. The one-second at each step allows time for the field in the part to reach a steady state, at which time induced currents become zero, permitting maximum penetration of the field into the part. This can easily be done using a continuously variable autotransformer or electronic decay circuitry to reduce the AC current to zero.

3.4.11.8.2.2 Circular Demagnetization.

NOTE

Circular demagnetization is particularly effective on parts of complicated shape, such as multiple throw cranks or coil springs.

Two techniques are used to circularly demagnetize parts: 1) the direct contact and 2) central conductor methods. The technique used depends upon the part’s size, shape, and the technique used to magnetize it. Generally, the same technique used to magnetize is used to demagnetize a part. Though the techniques used may be the same, the type of current required to demagnetize a part may differ from that used to magnetize it. For example, parts having large cross sections which have

been magnetized using AC may require step-down reversing DC to demagnetize them. The use of reversing DC overcomes the lack of field penetration, which occurs with AC.

3.4.11.8.2.3 Direct Contact Demagnetization. Alternately reversing and reducing the current in a part accomplishes demagnetization using the direct contact method. The part may be clamped between contact heads on a stationary unit having provision for demagnetization; or the part may be connected to cables and to a suitable demagnetizing current power supply. Starting with a current amperage greater than or equal to that used for magnetizing, the current is reduced to either zero or a very low amperage. Either AC or reversing DC may be used depending on the size, shape, and retentivity of the part. The AC demagnetization is usually less time consuming and is satisfactory for many small to medium-sized parts. However, for large parts or parts having thick cross sections, step-down reversing DC is required.

3.4.11.8.2.3.1 Parts having a complicated geometry or that have been magnetized using more than one current path through the part may not be completely demagnetized in one demagnetizing cycle. The same number of demagnetizing cycles may be needed, and through the same current paths, as were used for magnetization. Quite often with small, low retentivity parts, instead of repeat demagnetization on the part, a satisfactory and quicker demagnetization can be obtained using coil demagnetization with AC or reversing DC.

3.4.11.8.2.3.2 To circularly demagnetize a part by direct contact, clamp the part between the contact heads. Demagnetization is accomplished by automatically passing shots of decreasing current through the part. Care SHALL be taken not to demagnetize very small parts between the heads because the high initial current can overheat the parts. If longitudinal demagnetization is desired, the coil is then placed in position with the part still clamped in the heads. The same general procedure is followed, except the demagnetizing current passes through the coil instead of the part.

3.4.11.8.2.4 Central Conductor Demagnetization. The method used for direct contact demagnetization also applies to central conductor demagnetization. Demagnetizing currents SHOULD start from the same or slightly higher amperages than were used for magnetizing. Placement of the central conductor or threaded-cable configuration should be the same used for magnetization. Sometimes different central conductor locations or configurations must be used and be determined by experiment.

3.4.11.8.3 Demagnetizing With Mobile Equipment. Mobile equipment used for magnetization can also be used for demagnetization. Selecting a current output equal to or greater than the one used when magnetizing the part performs demagnetization. Cables are either formed into a coil of three or four turns, or wrapped around the part three or four times. The cables are then connected to the output terminals. On units without a demagnetization cycle, initiate the magnetizing cycle and pass the part through the coil or pass the coil over the part, leaving the current on until the coil and part are well separated (approximately 4 to 5-feet). On units incorporating a demagnetization capability, place the part in the coil, and initiate the demagnetization cycle that starts the automatic step-down of the applied current.

3.4.11.8.4 Demagnetizing With Portable Equipment. Portable equipment, other than hand probes or yokes will usually supply both alternating current and half-wave direct current. Demagnetization with this equipment and cables is done using alternating current through one of two methods, as follows:

- a. Make a coil with three or four loops of cable.
- b. Adjust the alternating current output to a higher level than used in magnetizing the part.
- c. Place the coil around the part and turn on the current.
- d. Then withdraw the coil four or five feet from the part and turn off the current; OR withdraw the part from the coil for four or five feet along the centerline of the coil and turn off the current.

3.4.11.8.4.1 Demagnetizing With Hand Probe or Yoke. Hand probes or yokes (AC or DC) provide a portable means for demagnetizing when other methods are impractical. In some cases, they are more effective than coil-type demagnetizers because the field of the probe or yoke can be concentrated into a relatively small area. For probes with adjustable legs, the space between the poles should be such that parts to be demagnetized will pass between them as close as possible. With AC flowing in the coil of the probe, parts are passed between the poles and withdrawn ([Figure 3-31](#)). On large parts, the probe is placed on the part and is moved around as it is slowly withdrawn. This method of demagnetizing is very effective. When the probe incorporates a DC magnetization capability, it can be used for DC demagnetization as well.

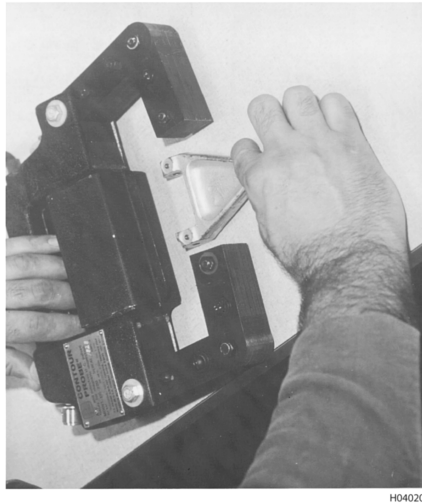


Figure 3-31. Non-Contact Demagnetization

3.4.11.9 Special Demagnetization Techniques. Where the size, shape, or techniques of part magnetization make demagnetization difficult, there are several techniques which may be used effectively. Most difficult parts can be demagnetized to the extent required for service by using the following techniques:

3.4.11.9.1 Rubber Mallet. Sometimes, striking the part with a rubber mallet during the demagnetizing operation can effectively demagnetize parts difficult to demagnetize. To use this technique, the part is placed in the demagnetizing coil and the current is turned on. The part is then hammered with a rubber mallet and withdrawn from the coil field while the hammering is continued. Care SHALL be taken so the hammering does not damage the part.

3.4.11.9.2 Positioning. Demagnetizing coils sometimes work better if they are positioned so the path of the part, as it is drawn through the coil, is in an east-west direction rather than north-south. This is particularly true for long parts that may be influenced by the earth's magnetic field.

3.4.11.9.3 Transient Demagnetization. Sometimes the residual field from heavy parts can best be removed by a technique known as the transient method of demagnetization. To perform this technique, the part is placed in the demagnetizing coil and the current turned on and off five to ten times. The current is then turned on and left on while the part is withdrawn from the magnetic field of the coil.

3.4.11.9.4 Demagnetization of Short Hollow and Cylindrical Parts. When a short, hollow, or cylindrical part is being demagnetized in an AC coil, by the method of withdrawing the part along the line of the axis of the coil, it is helpful to rotate the part both around the axis parallel to and transverse to the coil's axis. This should be accomplished while the part is in the coil as well as during the entire time of withdrawal. A part with an L/D ratio of one or less can sometimes be better demagnetized by placing it between two soft iron pole pieces of similar diameter, but longer than the part. This combination is then passed through the coil as a unit. It has the effect of increasing the L/D ratio and facilitates the removal of the field in the part.

3.4.11.9.5 Demagnetization of Ring-Shaped Parts. For the demagnetization of ring-shaped parts an effective method is to pass a central conductor through the ring. The central conductor is energized with AC and the current reduced to zero by means of either a step-down switch or a step less current control. The latter method can be quicker (down to a few seconds) than the step-down switch. This method can also be used with reversing, decaying, or step-down DC as well.

3.4.11.9.6 Demagnetization of Long Parts. Long parts, such as rods, bars, and tubes may retain an objectionable amount of residual magnetism from the earth's magnetic field. As the earth's field extends from the north to the south pole, it is desirable to demagnetize these types of parts by withdrawing from an AC coil in an east-west direction. This will minimize the effect of the earth's field on the residual magnetism in the parts.

3.4.11.9.7 Demagnetization of Large Structures. Frequently, large structures such as engine mounts may require demagnetization, and demagnetizing coils of suitable size may not be available. In such case, each individual extension from the structure, such as the legs of a mount, should be placed within the coil as close to the wall as possible and withdrawn. The structure should then be reversed. The other end is then brought close to the face of the coil and rotated, so all parts of the structure are passed across the open face of the coil. The entire structure is finally withdrawn four to five feet from the coil before it is shut off. In handling such tubular structures, it is important they be moved to and from the coil in an east-west direction.

3.4.11.9.8 Removal of Longitudinal and Circular Fields. In considering the problem of demagnetization, it is important to remember a part may retain a strong residual field after having been circularly magnetized, and yet exhibit little or no external evidence of such a condition. Such a field is difficult to remove and there is no easy way to check the success of demagnetization. There may be local poles on a circularly magnetized piece at projecting irregularities, changes or sections, that can be checked with a field indicator. However, to demagnetize a circularly magnetized part, it is often better to first convert the circular field to a longitudinal field. The longitudinal field does possess external poles, is more easily removed, and the extent of removal can be easily checked with a field indicator.

3.4.12 Post Inspection Cleaning.

CAUTION

All plugs and masks SHALL be removed after post-inspection cleaning and the part SHALL be demagnetized to the maximum extent possible.

3.4.12.1 Particle Removal. The magnetic particle inspection process leaves behind at least a scattering of magnetic particles that are abrasive. This may or may not be harmful to the part when it is subjected to further use. Where this slight residue cannot be tolerated, it SHALL be removed. When its presence makes no difference, post-inspection cleaning can be eliminated. Dry magnetic particle inspection leaves only the particles behind. These particles are fairly coarse, quite abrasive, and probably magnetically bonded to the test surface. The wet method magnetic particles are much finer than the dry method magnetic particles (0.0002-inch instead of 0.002-inch to 0.006-inch in diameter) and are softer, though still somewhat abrasive. On highly polished surfaces, residual powder from the bath can contribute to rapid corrosion.

3.4.12.2 Inspection Vehicle Removal. The wet method inspection process will normally leave the carrier liquid or vehicle on the test surface. If the vehicle is oil, it can be removed by vapor degreasing or solvent cleaning. If the vehicle is water, the residue will consist of wetting agents and water-soluble corrosion inhibitors, which may be removed with a plain water rinse or spray. Regardless of the type of vehicle used, the part SHOULD be cleaned as soon as possible after inspection and demagnetization.

3.4.12.3 Post-Cleaning Methods.

CAUTION

Post-cleaning methods that use water can cause corrosion of the test surfaces if the water is not promptly removed. The surfaces SHALL be thoroughly dried off by wiping, heating, or blowing with properly regulated compressed air.

Regardless of whether the wet or dry, visible or fluorescent, magnetic particle inspection process is used, once the carrier liquid or vehicle is removed, the requirement for removal of the magnetic particles is the same. Thoroughly demagnetize the part, and then remove the magnetic particles by wiping or scrubbing. Cleaners or detergents cannot break the magnetic attraction of a magnetized part. The particles cannot be dissolved from the part surface, as they are a ferrous oxide, so mechanical scrubbing or detergent washing may be necessary. Solvents may be used to remove the residue, and in some cases, the use of ultrasonic cleaning has been successful.

3.4.12.4 Requirements Following Post Inspection Cleaning. After inspection by the wet method using a petroleum distillate as the bath liquid, the surfaces of parts are left vulnerable to corrosion. The bath vehicle is, by specification, free of any residual non-volatile material and when it dries it leaves no protective film. Every effort SHALL be taken to clean a part

and apply a protective finish as soon as possible after the inspection. When water is the bath vehicle, the dried film on the surface of a part consists of the various conditioners used in the bath formulation in addition to the residual magnetic particles. One of the conditioners is a corrosion inhibitor, so this inhibitor affords some corrosion protection after testing. However, this is by no means permanent and a protective finish should be applied as soon as possible.

NOTE

In the event a functional material, such as oil, grease, or anti-seize compound is removed from the part to facilitate inspection, the same material SHALL be reapplied after the part has been inspected.

3.4.13 Magnetic Rubber Inspection.

3.4.13.1 Introduction. Magnetic rubber inspection (MRI) is a nondestructive inspection technique used for detecting cracks or other flaws on or near the surface of ferromagnetic materials. Its principal applications are in certain problem areas, such as (1) areas having limited visual accessibility (e.g., inside holes, tubes, etc.), (2) coated surfaces, (3) complex shapes or poor surface conditions, and (4) inspections for defects that require magnification for detection and interpretation. Magnetic rubber inspection involves the use of a material consisting of magnetic particles dispersed in a room temperature curing silicon rubber. The material is catalyzed, applied to the test surface, and the area to be inspected is magnetized, causing the particles to migrate through the rubber and accumulate at discontinuities on the surface. Following cure, the solid replica casting is removed from the part and examined for indications. The magnetic principles discussed in Section 2 ([Paragraph 3.2](#)) of this chapter apply equally to Magnetic Rubber Inspection.

3.4.13.1.1 Currently, there is only one manufacturer known to produce magnetic rubber materials. The example data presented in this section applies to that manufacturer's three material formulations; MR-502, MR-502K, & MR-502Y. However, the principles and instructions presented will apply to any material complying with SAE Specification AMS 83387.

3.4.13.1.2 MR-502 is the more viscous and slow curing of the three formulations, and provides medium sensitivity. It is usually not the best choice when highest crack detection sensitivity is required. MR-502K has the lowest viscosity and is the most sensitive. MR-502Y is MR-502K with a yellow coloring agent added. It is slightly more viscous and very slightly less sensitive than MR-502K. The yellow color makes the indications more noticeable to the inspector reading the replica, thereby improving the probability of detection for very small cracks. MR-502Y has a greater tendency to stick to the part surface after it is cured, so the use of a release agent will be required for more applications.

3.4.13.1.3 Some specifications refer only to MR-502 because this was the first material available. It is recommended cognizant engineering activities specify or authorize substitution of MR-502K or MR-502Y unless long gel time and lower sensitivity are desirable for the specific application.

NOTE

Technical directives, requiring a magnetic rubber inspection SHALL specify the formulation to be used, including any alternatives, in the procedure.

3.4.13.2 Safety Precautions. General safety precautions are applicable to magnetic rubber inspection ([Paragraph 3.8](#)). The silicon rubber, dibutyltin dilaurate, stannous octoate, cure stabilizers, cleaners, and release agents are, or can be, skin and eye irritants, skin sensitizers (e.g., causing allergic reactions), inhalant, and ingestion hazards. For specific information concerning any of the materials used as magnetic rubber, magnetic rubber catalysts, release agents, or cleaners, consult the Material Safety Data Sheets, or contact the appropriate Safety Officer. Silicon oil is an ingredient in the material and can result in very slippery surfaces, especially floors, if not well controlled.

3.4.13.2.1 When performing magnetic rubber inspection on aircraft using electromagnets to magnetize, the aircraft SHALL be grounded.

3.4.13.3 Gel Time (Cure Time). Gel time (also called cure time or pot life) refers to the time from the addition of the catalyst to when the viscosity starts to noticeably increase and magnetization must be completed. Cure time is the time to completely cure to a tack-free state.

3.4.13.4 Magnetic Rubber Inspection Procedure (Typical).



Areas to be magnetic rubber inspected must be free of grease, oil, dirt, and other foreign matter that could cause false or confusing indications or prevent the base material from curing.

NOTE

This procedure is provided as an example and is not authorized for use unless specified and/or approved for a specific application by a cognizant MT Level III. Directive originators SHALL obtain Level III concurrence prior to issuing a directive requiring a magnetic rubber procedure.

A general list of the required materials and equipment to obtain is contained in [Table 3-4](#) and [Table 3-5](#). Materials and equipment required for a specific inspection SHOULD be identified in the task specific directive.

Table 3-4. Magnetic Rubber Equipment

Electromagnetic yoke, fixed or articulated legs (same as used for magnetic particle inspection)
Permanent bar magnets
Soft iron pole pieces
Stereo zoom microscope (7-10X or higher) with high intensity light (mandatory)
Electronic gauss meter
Mechanical shaker (e.g., paint shaker)
Vacuum chamber

Table 3-5. Magnetic Rubber Inspection Materials

Base material
Dibutyltin Dilaurate and Stannous Octoate catalysts
Sealing compound (putty for forming dams)
Aluminum or plastic sheet material for forming dams
Release agent to aid in the removal of replicas from holes (not silicone based)
Paper or plastic cups in which to mix magnetic rubber material
Tongue depressors for mixing the material
Isopropyl alcohol for cleaning replicas
Disposable syringe for applying the rubber mixture to the inspection area

3.4.13.4.1 Part Preparation. Prepare the part for magnetic rubber inspection as follows:

CAUTION

If a delay is expected that would leave any area of steel in a bare metal state for over 1-hour, protect the area from corrosion per NAVAIR 01-1A-509 (TO 1-1-691/TM 1-1500-344-23), [Chapter 3](#). Volatile corrosion inhibitor (VCI) film MIL-PRF-22019 held on and sealed at the edges with AMS-T-22085 Type II preservation tape is effective and convenient where the part geometry allows its use. Upon removal of VCI film the area is not required to be cleaned again.

- a. Using cheesecloth or equivalent moistened with cleaning solvent; remove grease, oil, dirt, lint, and similar contaminants from the area to be inspected. Refer to NAVAIR 01-1A-509 (TO 1-1-691/TM 1-1500-344-23), [Chapter 3](#) for specific instructions and approved materials.
- b. Remove loose corrosion products, sealants, paint, plating, and other coatings, as required by the task specific directive. If removal requirements are not specified, remove all corrosion products and coatings except primer and plating which, may be left on the surface if they do not exceed 0.005 inch in total thickness. Normal primer and corrosion preventive plating MAY be assumed to not exceed 0.005 inch thick.

NOTE

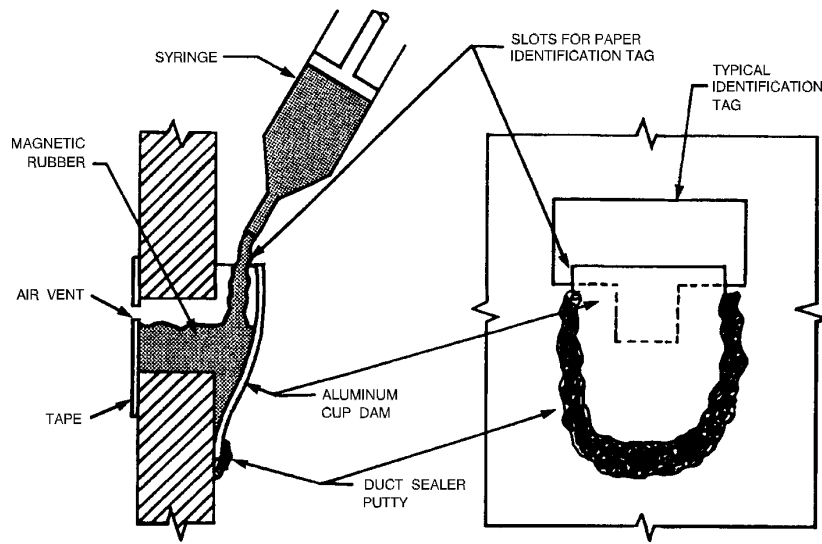
- Using the procedures and materials as discussed above, virtually any area or configuration can be prepared for magnetic rubber inspection. Upside-down surfaces may be inspected by building a reservoir beneath the test area and pressure filling with magnetic rubber. A vent hole must be provided with this type of reservoir to prevent air entrapment.
- When building dams, make certain they are small enough to allow magnets or the legs of an electromagnet to span the reservoir. Magnets or the legs of an electromagnet SHOULD NOT be placed into the uncured magnetic rubber.
- c. Prepare a dam around the surface or hole to be inspected. Examples are shown in [Figure 3-32](#). Use tape, aluminum foil, special sealing putty, and specially made dams (singly or in combination) to form a reservoir to hold the magnetic rubber.

NOTE

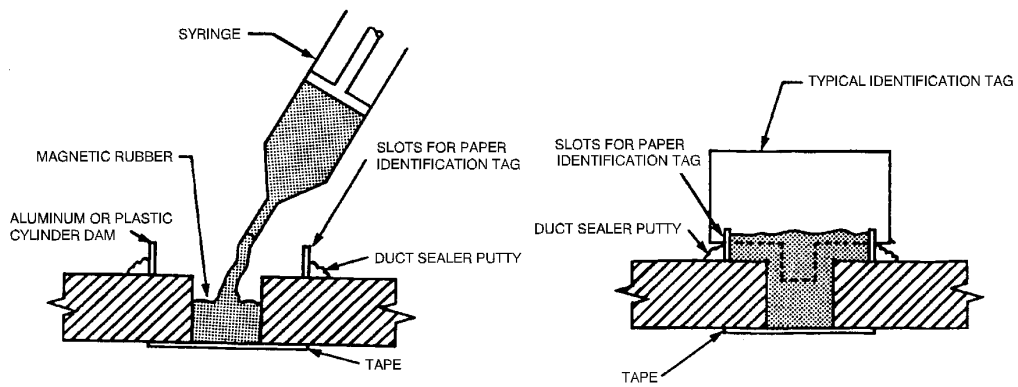
The steps in [Paragraph 3.4.13.4.2](#) through [Paragraph 3.4.13.4.7](#) are for pre-magnetization setup and adjustment. Magnetization will be conducted after addition of the magnetic rubber.

3.4.13.4.2 Select Method of Magnetization. Magnetism may be applied with portable electromagnets (yokes), permanent magnets, or conventional magnetic particle inspection equipment. DC or rectified AC current must be used to electrically generate the magnetic field. An AC generated field will not be effective with slow-moving particles. In areas of limited accessibility, soft iron, low alloy steel extensions, or pole pieces are used to transfer magnetism into the inspection area. Permanent magnets are useful in certain specialized applications, such as threaded bolts, gears, or other small parts whose shape makes magnetization difficult with an electromagnet. The magnetic fields produced in large parts by permanent magnets are often quite low and unpredictable; therefore, they SHOULD NOT be used on such parts unless a specific procedure has been developed and verified. Central conductors are effective for fastener and attachment holes; particularly when there are multiple layers of materials and the layer being inspected is not accessible to an electromagnetic yoke.

3.4.13.4.3 Select the Method of Magnetic Contact. Field strength is greatly reduced when there is poor contact between the magnet and the test piece. To improve contact, auxiliary pole pieces are useful as illustrated in [Figure 3-33](#). These may be machined from soft iron and attached to the poles of magnets. Pole pieces SHOULD be designed to have the least reduction in cross-section consistent with space requirements.



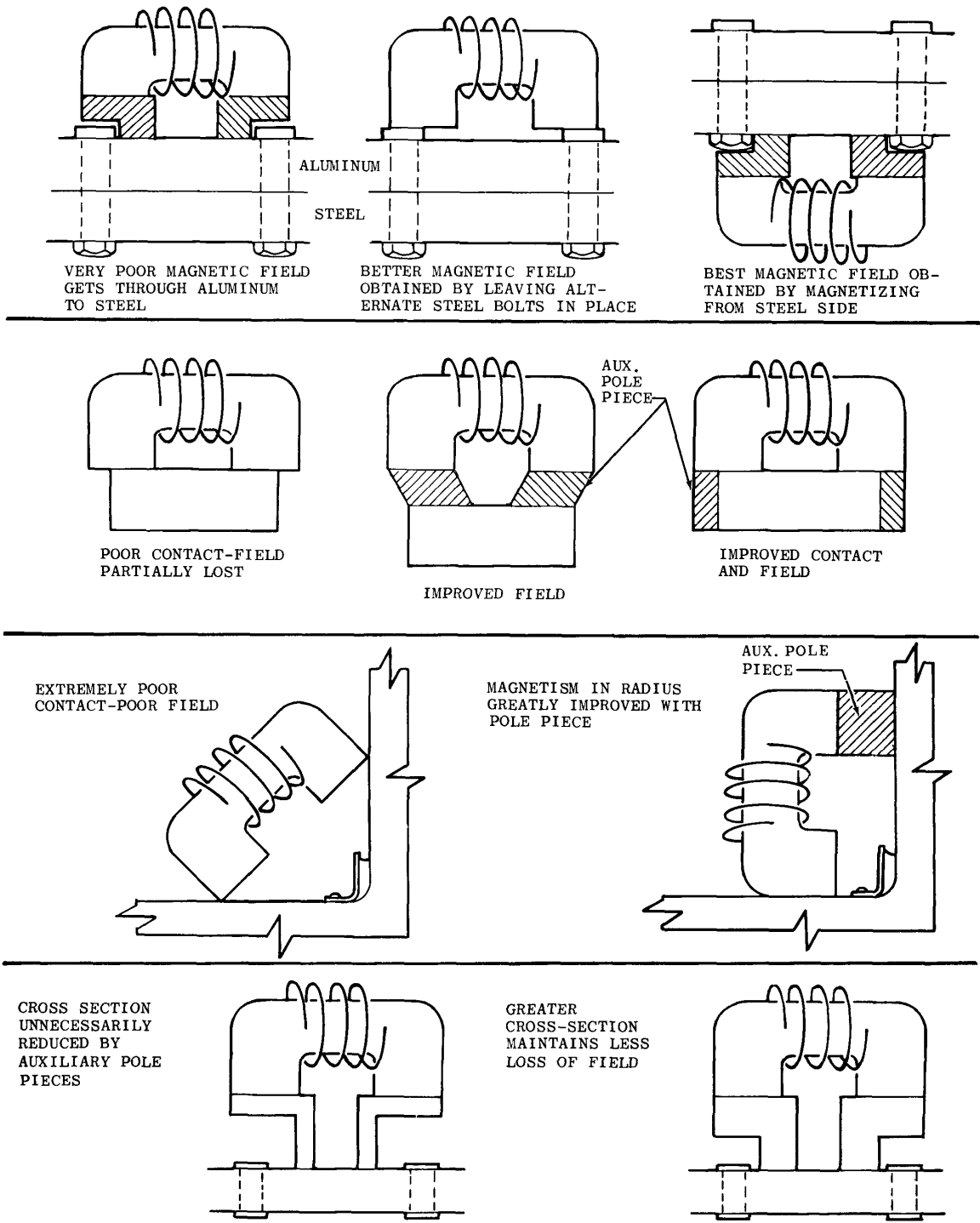
HORIZONTAL HOLE PREPARATION



VERTICAL HOLE PREPARATION

H0402013

Figure 3-32. Preparation for Magnetic Rubber Inspection



H0402014

Figure 3-33. Using Pole Pieces to Improve Magnetic Contact

3.4.13.4.4 Determine the Magnetic Field Requirements. Magnetic field recommendations (strength and duration) for inspection of holes and surfaces are shown in [Table 3-6](#). These are recommended starting points; actual requirements are those that produce inspection replicas with the needed defect detection sensitivity.

Table 3-6. Magnetic Field Strength and Duration Recommendations

(Variations may be required for specific applications.)			
Inspection Area	Magnetic Rubber Base Material	Field Strength (Gauss)	Magnetization Duration, Each Direction
Hole (bare)	MR-502 (NSN 6850-01-037-9015)	50 to 100	30 seconds
	MR-502K (NSN 6850-01-163-0276)	30 to 50	30 seconds
	MR-502Y (NSN 6850-01-163-0277)		
Surface (bare)	MR-502 (NSN 6850-01-037-9015)	150	1 minute
		100	3 minutes
		50	10 minutes
	MR-502K (NSN 6850-01-163-0276)	100	30 seconds
		50	1 minute
		30	2 minutes
MR-502Y (NSN 6850-01-163-0277)			
Coated Holes and Surfaces	Extend magnetization duration from the times listed above depending on coating thickness.		

3.4.13.4.5 Determine Field Direction. Since cracks and other flaws are displayed more strongly when they lie perpendicular to the magnetic lines of force, the magnetism SHOULD be applied from two directions to increase reliability when the flaw direction is unknown or uncertain. Usually this is accomplished by magnetizing in one direction and then rotating the magnetization source 90-degrees and magnetizing again. When the direction of a suspected defect is known, only one magnetizing direction is required.

3.4.13.4.6 Measure the Magnetic Field Strength. Measure the magnetic field strength using a gauss meter by placing the probe in the hole or on the surface to be inspected. Most electronic gauss meters have interchangeable probes to permit measurement of the magnetic field either parallel or perpendicular (transverse) to the axis of the probe. The transverse probe, which can measure the field parallel to the part surface, will be used most often. Refer to the operating manual for the gauss meter for specific operating instructions.

3.4.13.4.7 Adjust the Magnetic Field Strength.

3.4.13.4.7.1 Electromagnets. The magnetic field strength is adjusted to the recommended value from [Table 3-6](#) by adjusting the control knob of the magnetization power supply. The control knob reading and the position of magnet and pole pieces are noted so these settings can be repeated when final magnetization is performed after addition of the rubber formulation.

3.4.13.4.7.2 Permanent Magnets. Appropriate bar magnets are placed to obtain the needed field strength and direction.

3.4.13.4.8 Mix, Measure, and Deaerate. Mix, measure, and deaerate (only if bubbles in replica are a problem) magnetic rubber base material as follows:

3.4.13.4.8.1 Mixing. The magnetic rubber base material must be thoroughly mixed prior to use. Prior to measuring or weighing a quantity of magnetic rubber it SHOULD be thoroughly mixed with a wooden tongue depressor or a spatula. Mixing SHOULD continue until the material contains no streaks or color variations. Materials that have settled SHOULD be agitated on a mechanical shaker (paint shaker or equivalent). Steel balls may be placed in the container containing the magnetic rubber to facilitate thorough mixing.

3.4.13.4.8.2 Measuring. The magnetic rubber base material may be weighed or measured, volumetrically, into paper cups or other suitable containers. One gram of magnetic rubber base material is equal to one cubic centimeter (cc) of base material. The number and size of the batches measured must be based on the area to be inspected. Do not measure more material per

batch than can be poured and magnetized within the gel time of the formula selected. To determine the gel time at the time of inspection, measure a small trial batch and time the gel time in the mixing cup before the inspection batch is mixed and poured.

3.4.13.4.8.3 Deaerating. Deaerate the base material for inspections of horizontal holes, upside-down surfaces and any time bubbles interfere with interpretation of the replica. The magnetic rubber base material is placed in a vacuum chamber and pumped down to 25 to 30-inches of mercury for one to two minutes. This will remove excess air and help prevent the formation of bubbles on the upper surfaces of the cured replicas.

Table 3-7. Cure Times for Different Amounts of Catalyst

Material	Gel Time	Cure Time
MR-502	8 min.	1 hr.
	15 min.	2 hrs.
	30 min.	4 hrs.
MR-502K and MR-502Y	2 min.	5 - 10 min.
	3 min.	10 - 15 min.
	5 min.	15 - 20 min.
	10 min.	1 hr. 15 min.

3.4.13.4.9 Add Magnetic Rubber.

NOTE

- The magnetic rubber will begin to thicken when curing agents are added. Therefore, magnetization must begin immediately and the entire batch must be magnetized before the gel time of the formula has expired.
- Magnetic rubber material, catalyst addition, and cure time are based on a room temperature of 76°F. The cure times are very unpredictable when the temperature is below 60°F or over 90°F.
- When inspecting deep holes with small diameters, with scored surfaces, or of unusual configuration, the inspection area may be coated with a thin film of release agent to aid in removal of the replica.

Add to the magnetic rubber base material the correct number of drops of catalysts, and cure stabilizer according to the instructions provided with the material by the manufacturer. Typical combinations of gel time and cure times attainable by varying the amount of catalyst added is shown in [Table 3-7](#). Higher humidity or higher temperature will increase the cure rate. When temperature or humidity change, or when material from a different batch is first used, mixing a small test batch to determine optimum ratios of catalyst to base material is recommended. If the cure is too fast and the rubber starts to gel before the magnetization is complete, the process will have to be repeated. If the cure is too slow, time is lost waiting for the replica to solidify enough for removal.

3.4.13.4.10 Mix. Using a tongue depressor or equivalent, thoroughly stir the mixture. Avoid whipping air into the mixture.

3.4.13.4.11 Fill. Using the mixing container or a syringe, fill only the number of holes or other test areas that can be magnetized within the gel time. Following fill, vent holes SHOULD be sealed with putty to prevent the continual flow of rubber.

NOTE

Holes in steel having high retentivity may be magnetized by a “residual” method. Using this method, the hole is filled with magnetic rubber and is magnetized with an electromagnet at the maximum field obtainable for a period of about one second. This SHOULD establish a residual field of 25-100 gauss to be effective. This field must stay undisturbed for 30 to 60-seconds (depending on the level of residual magnetism). Do not magnetize the hole in a second direction or magnetize any other hole on the same test part until the 30 to 60-seconds have elapsed.

3.4.13.4.12 **Magnetize.** Magnetize each test area according to the pre-magnetization setup established in [Paragraph 3.4.13.4.2](#) through [Paragraph 3.4.13.4.7](#).

3.4.13.4.13 **Identify.** Replicas can be identified by inserting an identification tag into the rubber before it gels, or by individually bagging the completed replica along with the identification.

NOTE

Care SHALL be exercised to avoid disturbing the magnetic rubber in the area of interest when inserting a tag.

3.4.13.4.14 Allow magnetic rubber to cure for the time specified. Avoid movement of the part and contamination of the magnetic rubber by foreign matter.

3.4.13.4.15 Determine if the magnetic rubber is cured (tack-free) by lightly touching the replica or the material remaining in the mixing container.

3.4.13.4.16 Remove each replica as follows:

- a. Remove the magnets if applicable.
- b. Remove tape, aluminum dam, duct sealer putty, and/or central conductor and dam assembly.
- c. Gently remove replica from test area.

NOTE

The replicas tear easily.

3.4.13.4.17 Visually examine replicas for overall condition and proper identification. A stereomicroscope providing magnification of at least 10X magnification, and a high intensity illuminator SHALL be used for microscopic examination as follows:

- a. Adjust the illuminator so the light does not produce a glare on the surface of the replica. A good stereomicroscope with excellent light gathering characteristics and a strong light projected at a shallow angle is generally best for this work. Experience has proven that using a mediocre microscope or inadequate lighting may result in small cracks going undetected. The inspector may check the adjustment of the illuminator periodically on a replica known to display a faint crack indication.
- b. Hold the replica with finger tips and focus by lowering or raising the replica beneath the microscope lens (rather than raising or lowering the lens itself). This allows the inspector to view the replica at various angles and to scan the entire area of interest.
- c. Evaluate the level of magnetism. Although magnetic rubber responds satisfactorily to a wide range of magnetism, the reliability is increased if the optimum level is used. Too little magnetism will result in faint indications easily missed. Too much magnetism darkens the background so indications might be hidden. The experienced inspector can determine if the magnetism level is satisfactory by the appearance of the replica. For a hole magnetized with a yoke or permanent magnet, adequate magnetism is indicated on the replica by a dark "halo" around the edge ([Figure 3-35](#)). Adequate magnetism on flat surfaces and areas of gentle contour is indicated by darkness in the rough areas of the replica. On very smooth surfaces, external "penetrameter type" indicators such as staples, nickel foil, or other magnetic material may be taped to the part to indicate magnetism.
- d. Evaluate the replica quality. Replicas that contain excessive air bubbles, debris, or poorly mixed rubber are difficult to interpret and SHOULD be recast. Correct any technique or procedural errors. Clean the inspection area down to bare metal if necessary. Vary the inspection technique as appropriate.
- e. Evaluate indications of discontinuities and report relevant ones as required by the directive specifying the inspection.

- f. A replica may show obvious surface defects (tool marks, corrosion pitting, etc.) not attracting magnetic particles. The inspector is not responsible for identifying this type of defect unless the procedure specifically requires such identification.

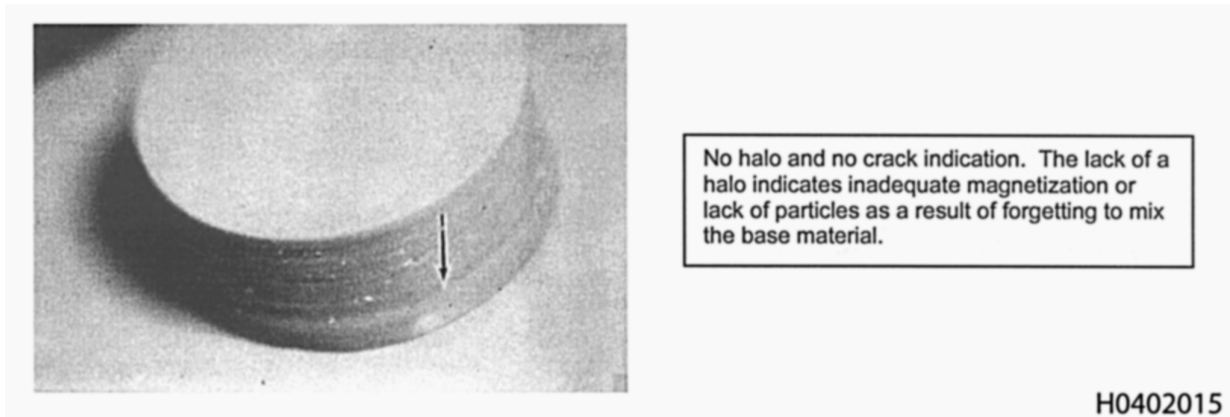


Figure 3-34. Magnetic Rubber Replica With No Indication

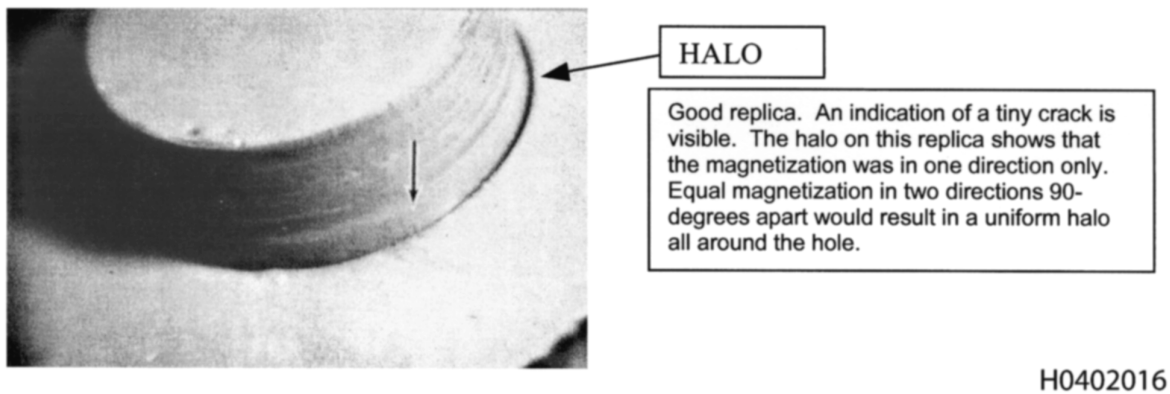


Figure 3-35. Magnetic Rubber Replica With Good Indication

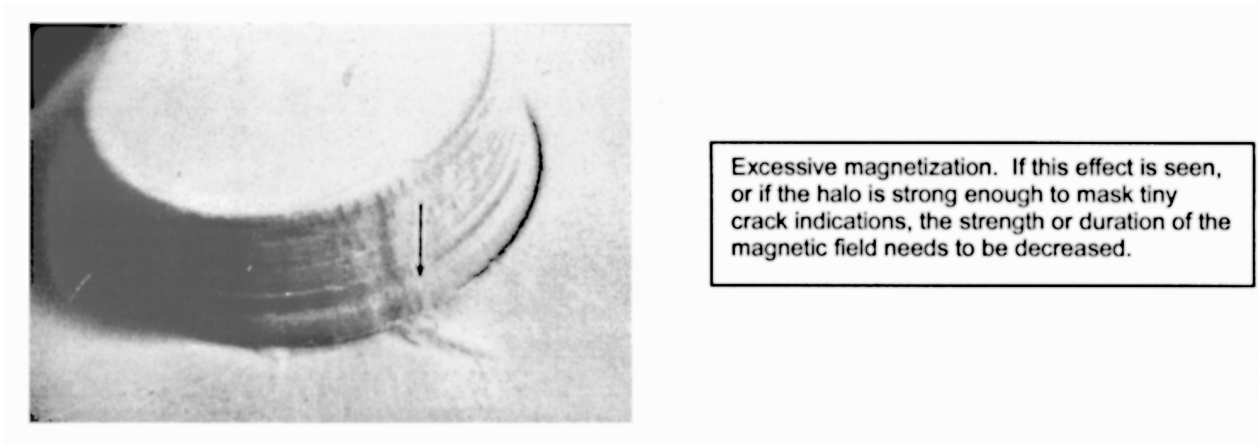
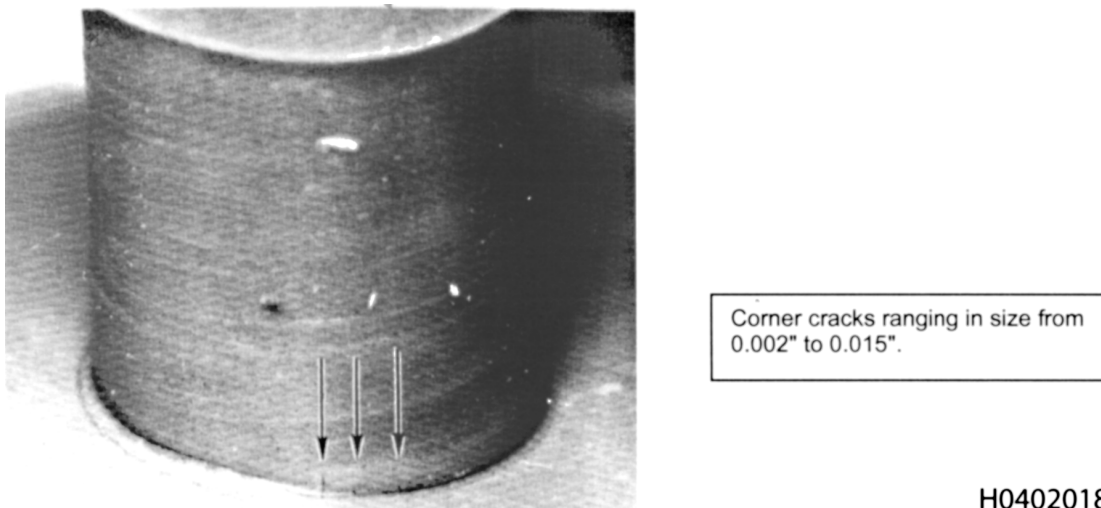


Figure 3-36. Magnetic Rubber Replica With Excessive Magnetization



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Figure 3-37. Magnetic Rubber Replica With Crack Indications

3.4.13.5 Post-Inspection Procedures.

- Demagnetize parts until the residual magnetism is less than two gauss measured with the electronic gauss meter, or two divisions on the magnetic field indicator.
- Clean parts with cleaning solvent. Refer to NAVAIR 01-1A-509 (TO 1-1-691/TM 1-1500-344-23), [Chapter 3](#) for specific cleaning instructions and approved materials.
- Restore finish or apply preservative promptly if corrosion preventive plating is not present or has been breached. High strength steels like 300M and Aermet 100 in current use on high performance military aircraft are extremely sensitive to stress-corrosion cracking. Harmful corrosion can start on these materials in a matter of hours. Refer to NAVAIR 01-1A-509 (TO 1-1-691/TM 1-1500-344-23), [Chapter 3](#) for specific preservation instructions and approved materials.

SECTION V MAGNETIC PARTICLE INSPECTION INTERPRETATIONS

3.5 MAGNETIC PARTICLE INSPECTION INTERPRETATION.

3.5.1 Formation of Discontinuities and their Indications.

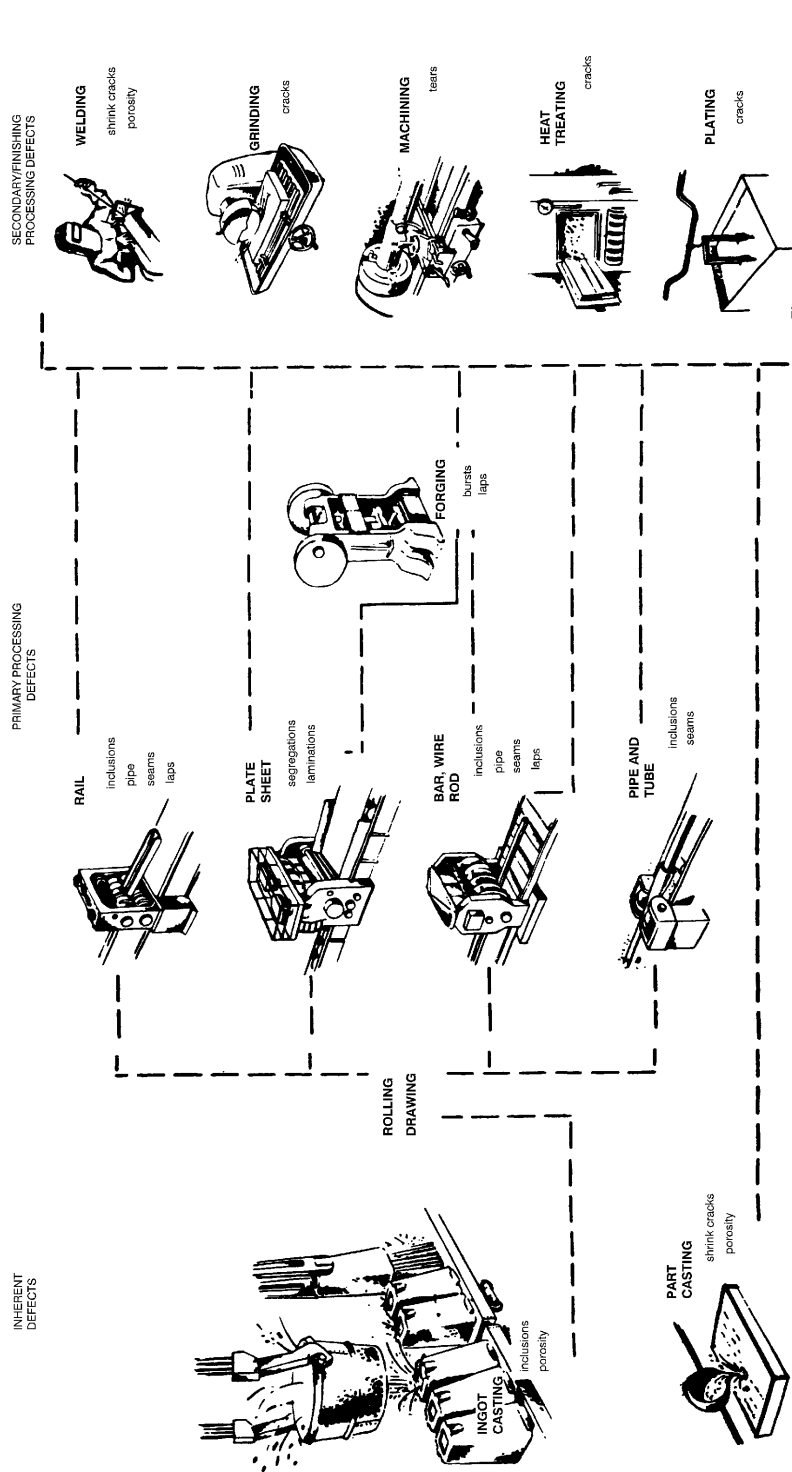
3.5.1.1 The Iron and Steel Manufacturing Processes. Knowledge of iron and steel manufacturing processes is necessary to enable an inspector to interpret and evaluate magnetic particle indications. It is not possible in this manual to explain all of the processes used in the manufacture of iron and steel parts, but a brief review will explain how some discontinuities are formed.

3.5.1.1.1 Purpose of Processing. Iron ore is converted into metal by heating it in a furnace. When it becomes liquid or molten, iron can be poured into molds and allowed to cool and solidify. In the molten state, it is possible to remove impurities and also to add other elements to form alloys. These additions, along with other appropriate metal processing steps, impart desirable properties to the finished metal that can make it:

- * Harder
- * Softer
- * Tougher
- * Stronger
- * Easier to machine
- * Resistant to heat
- * Resistant to corrosion

3.5.1.2 Ingot Production. After melting, purifying, and alloying the iron or steel, the molten metal is poured into an ingot mold where it is allowed to solidify. Most impurities rise to the top of the ingot before the metal is completely solid. However, some of the foreign materials can become trapped within the ingot during solidification. Because such entrapment is usually concentrated near the top, the ingot is cropped to remove most of the impurities.

3.5.1.3 Primary and Secondary Processing. Ingots undergo primary processing to form the metal into basic shapes according to end-product requirements. Secondary processing is subsequently used to manufacture the final products. A pictorial story of steel processing ([Figure 3-38](#)) shows in sequence the principal stages or operations where defects may be created, and indicates the defects most likely to be found in the material as it leaves each stage. This illustration SHOULD be studied in conjunction with the text in this section.



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Figure 3-38. Sequence of Steel Processing Stages, Indicating the Principle Operations and the Defects Most Likely to be Found in the Material After Each Process

3.5.2 Definition of Terms. The magnetic particle inspector SHALL understand the distinctions between a discontinuity, an indication, and a defect.

3.5.2.1 Discontinuity. A discontinuity is an interruption in the normal physical structure or properties of a part. Discontinuities may be cracks, laps in the metal, folds, seams, inclusions, porosity, and similar conditions. A discontinuity may be very fine or it may be quite large. A discontinuity may or may not be a defect; that is, it may or may not affect the intended use of the product or part. A discontinuity, which would be a defect in one part, may be entirely harmless in another part designed for a different service.

3.5.2.2 Indication. An indication is an accumulation of magnetic particles being held by a magnetic leakage field to the surface of a part. The indication may be caused a discontinuity, by some other condition that produces a leakage field, or by mechanically held particle accumulation.

3.5.2.3 Defect. A defect is a discontinuity that interferes with the intended use of a part.

3.5.3 Basic Steps of Inspection. Magnetic particle inspection can be divided into three basic steps:

- Producing an indication on a part.
- Interpreting the indication.
- Evaluating the indication.

3.5.3.1 Producing an Indication. In order to produce a proper indication on a part, it is necessary to have some knowledge of the principles of magnetism, the materials used in inspection, and the technique employed. Since these subjects have been covered in previous sections of this manual, observance of the procedural steps therein should ensure a proper indication is produced.

3.5.3.2 Interpreting the Indication. After the indication is created, it is necessary to interpret that indication. Interpretation is the determination of what caused that indication. Knowledge of metal processing is often invaluable in identifying the cause of an indication.

3.5.3.2.1 Indications caused by a discontinuity at the part surface are characterized by particles tightly held to the surface by a relatively strong magnetic leakage field. The particle accumulation has well defined edges and there is a noticeable “build-up” of the particles. This build-up consists of a slight mound or pile of particles, on which deep surface cracks are sometimes high enough above the part surface to cast a shadow. If such an indication is wiped off, the discontinuity can usually be seen.

3.5.3.2.2 Indications caused by a discontinuity below the surface are characterized by a broad and fuzzy looking accumulation of particles. The particles in such an indication are less tightly held to the surface because the leakage field is weaker.

3.5.3.2.3 The difference in appearance between indications of surface and subsurface discontinuities is clearly shown in [Figure 3-39](#) and [Figure 3-40](#). Notice the sharpness and definition of the accumulation of magnetic particles in [Figure 3-39](#). The pattern in [Figure 3-39](#) is much broader than in [Figure 3-40](#) and is quite typical of the indications formed over subsurface discontinuities.

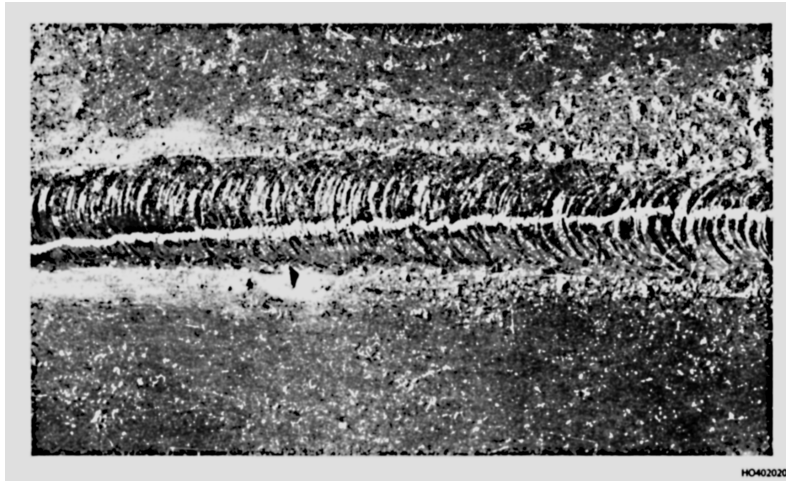


Figure 3-39. Sharp, Well Defined Indication of Surface Discontinuity in a Weld

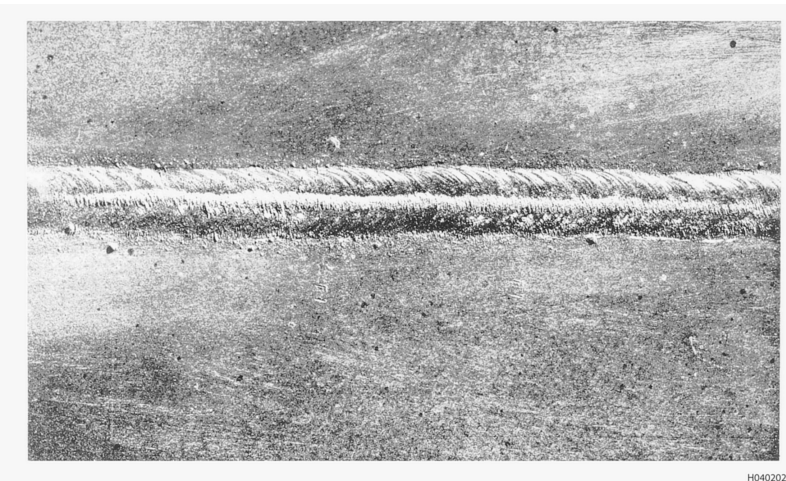


Figure 3-40. Broad Indication of Subsurface Discontinuity in a Weld

3.5.3.3 Evaluating the Indication. Finally, after the indication has been formed and interpreted, it must be evaluated. Evaluation helps determine the consequences of the discontinuity. This includes determining if the discontinuity is a defect and if so, can the part be reworked or repaired, or must the part be scrapped.

3.5.3.3.1 Generally, an inspector has fairly detailed guidance concerning the interpretation and evaluation of indications included with the procedure by which the inspection was done. In the event such guidance is not available, the following basic considerations may be used in conjunction with the inspector's knowledge and experience to help with indication evaluation.

3.5.3.3.1.1 A discontinuity of any kind lying at the surface is more likely to be harmful than a discontinuity of the same size and shape which lies below the surface.

3.5.3.3.1.2 Any discontinuity, whether surface or sub-surface, having a principal dimension, a principal plane which lies at right angles, or at a considerable angle to the direction of principal stress, is more likely to be harmful than a discontinuity of the same size, location, and shape lying parallel to the stress.

3.5.3.3.1.3 Any discontinuity that occurs in an area of high stress SHALL be more carefully considered than a discontinuity of the same size and shape in an area where the stress is low.

3.5.3.3.1.4 Discontinuities that are sharp, such as grinding cracks or fatigue cracks, are severe stress risers and are more harmful in any location than rounded discontinuities, such as scratches.

3.5.3.3.1.5 Any discontinuity that occurs in a location close to a keyway or fillet SHALL be considered more harmful than a discontinuity of the same size and shape occurring away from such a location.

3.5.3.3.2 Magnetic Particle Indications. Discontinuities in the part under examination will produce indications. These indications may not always be associated with physical discontinuities. Indications may be caused by:

3.5.3.3.2.1 An actual physical discontinuity at or near the surface of a part, which may have been present in the original metal or may have been produced by subsequent forming, heating, finishing processes, or service use [Figure 3-41](#).

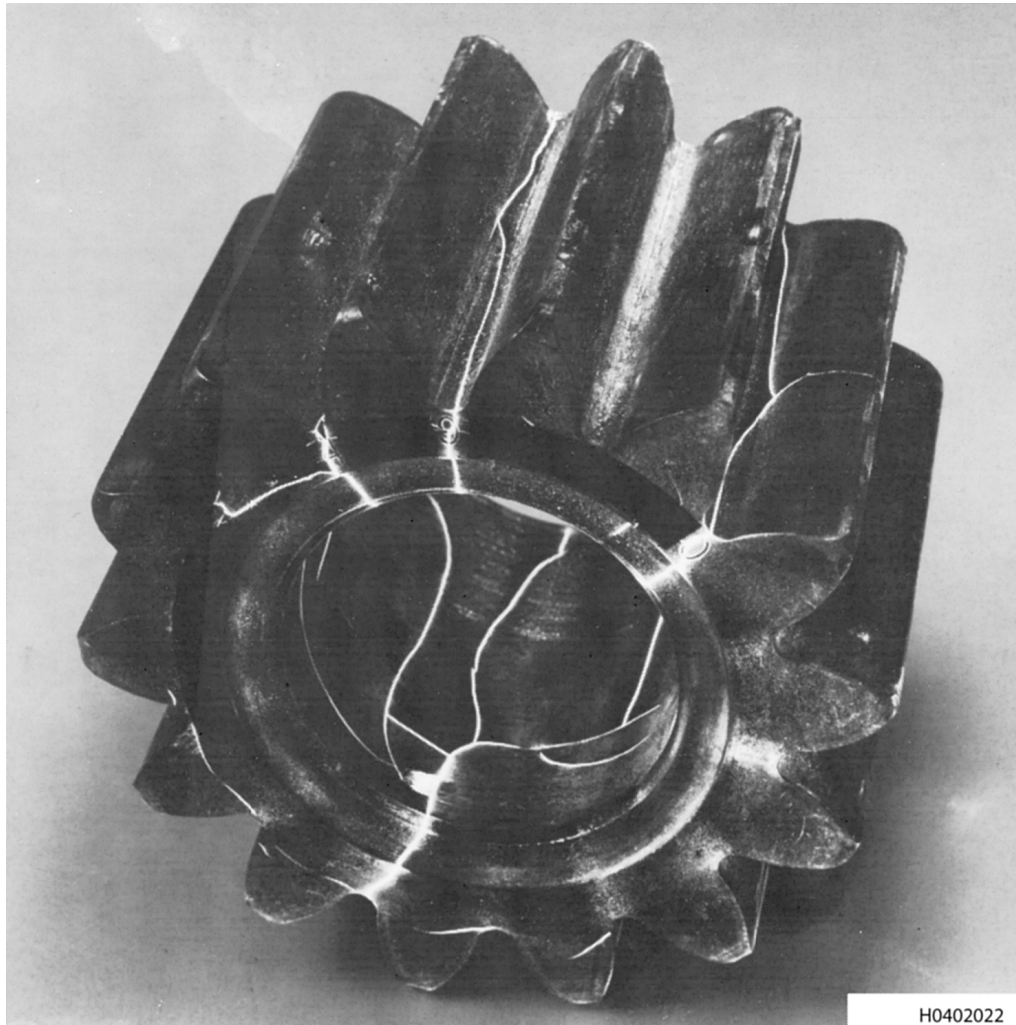


Figure 3-41. Typical Magnetic Particle Indications of Cracks

3.5.3.3.2.2 Actual physical discontinuities which are present by design (e.g., an interference or close fit between two members of an assembly) [Figure 3-42](#).

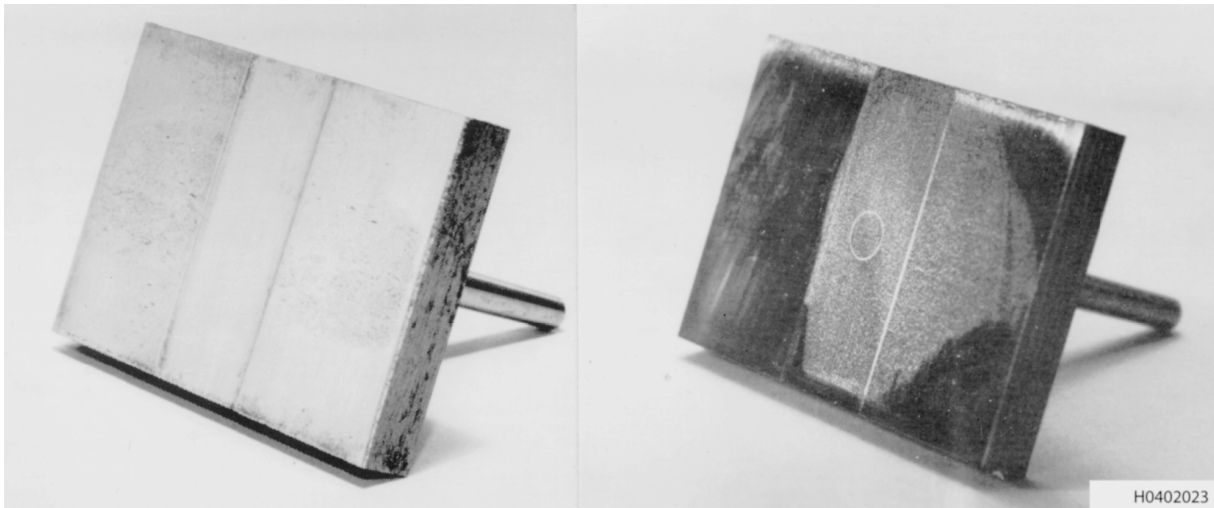


Figure 3-42. Magnetic Particle Indication of a Forced Fit

3.5.3.3.2.3 A weld between two dissimilar ferromagnetic metals having different permeabilities; or between a ferromagnetic metal and a nonmagnetic material. Indications may be produced at such a point even though the joint is perfectly sound. Such an indication may be produced in a friction or flash weld of two dissimilar metals ([Figure 3-43](#)).

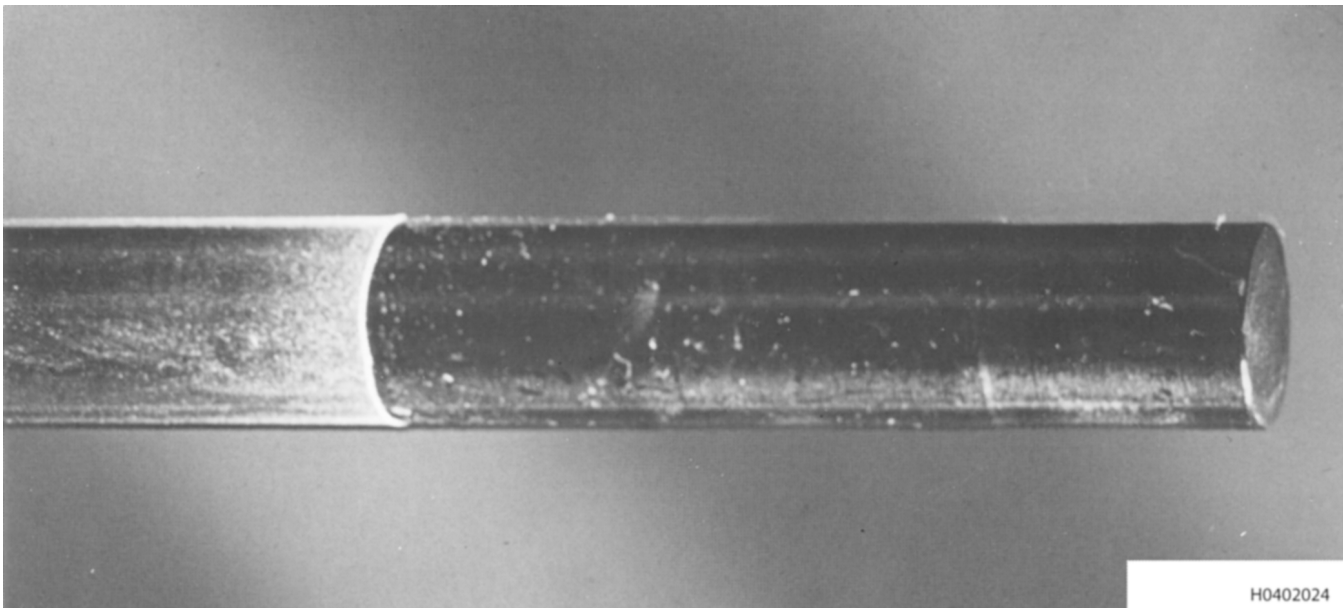


Figure 3-43. Particle Indication at the Weld Between a Soft and a Hard Steel Rod

3.5.3.3.2.4 The junction between two ferromagnetic metals by means of nonmagnetic bonding materials, as in a brazed joint. An indication will be produced though the joint itself may be perfectly sound ([Figure 3-44](#)).

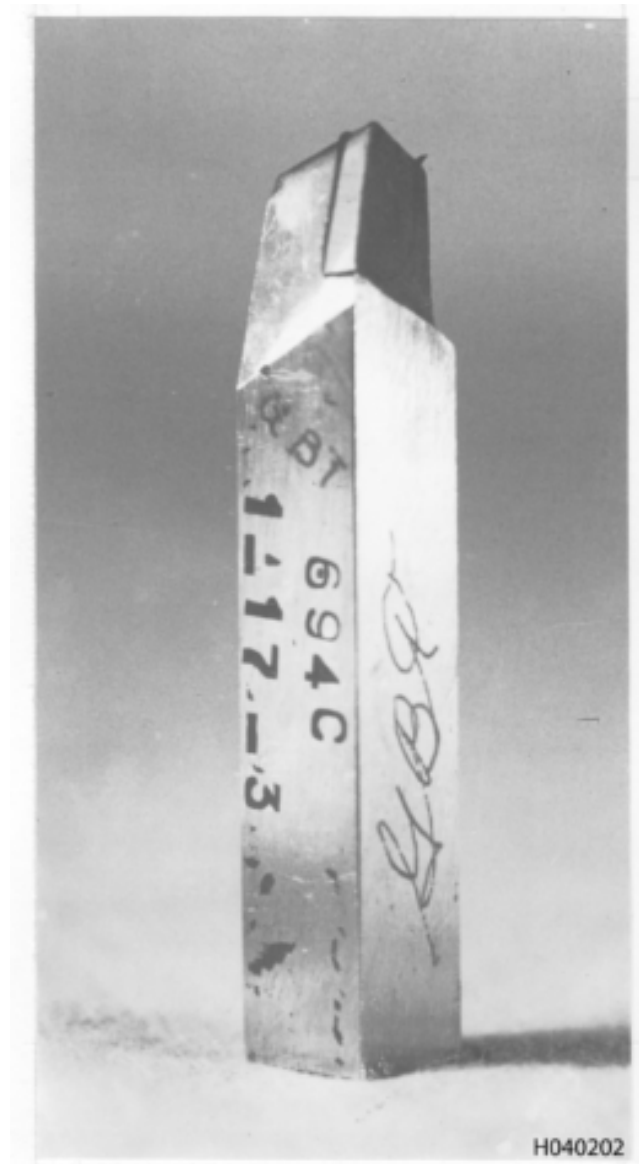


Figure 3-44. Magnetic Particle Indication of the Braze Line of a Brazed Tool Bit

3.5.3.3.2.5 Segregation of the constituents of the metal, where these have different permeabilities (e.g., low carbon areas in a high carbon steel, or areas of ferrite, which is magnetic, in a matrix of stainless steel which is austenitic and therefore non-magnetic). Another example would be in the weld zone and/or the heat-affected zone in welds between details of the same alloy ([Figure 3-45](#)).

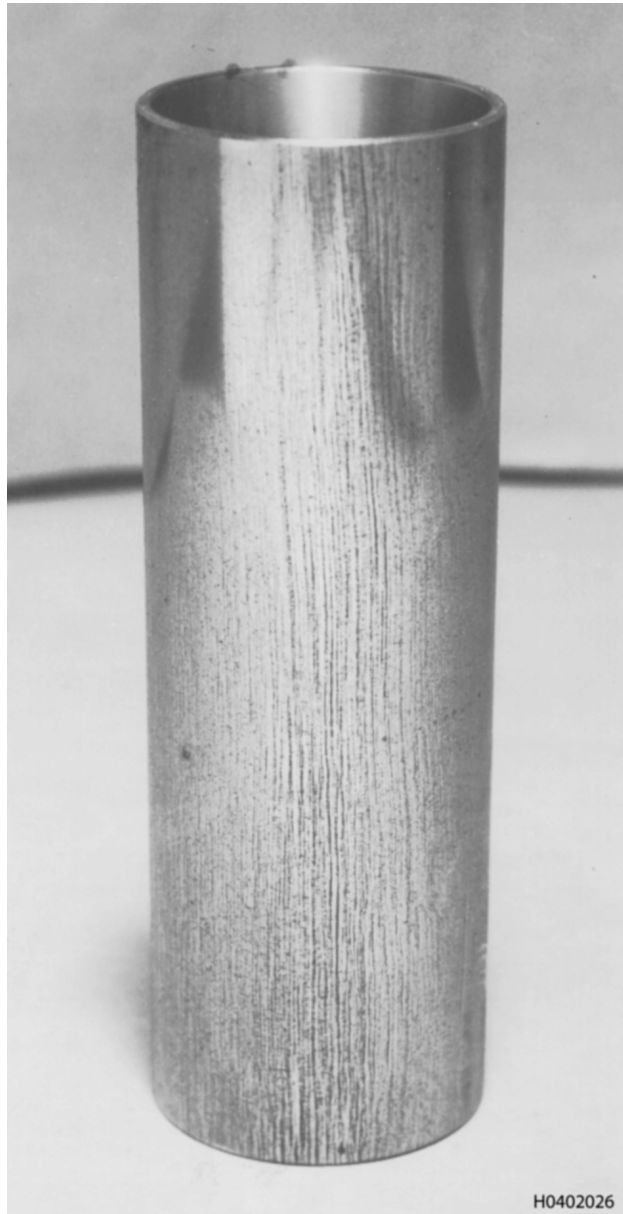


Figure 3-45. Magnetic Particle Indications of Segregations

3.5.4 Classes of Discontinuities. There are a number of ways to classify discontinuities that occur in ferromagnetic materials and parts.

- Class by Location. One broad grouping is based on location (surface discontinuity or subsurface discontinuity). The ability of magnetic particle inspection methods to locate members of these two groups varies sharply, but beyond this, the classification is too broad to be very useful.
- Class by Process. Another possible system is to classify discontinuities by the process that produced them. Although such a system is too specific to be suitable for all purposes, it is used extensively. When speaking of forming defects, welding defects, heat-treating cracks, grinding cracks, etc. Practically every process, from the original ore refinement to the last finishing operation, can and will introduce discontinuities which magnetic particle testing can find. Therefore, it is important that the nondestructive testing engineer or inspector to be aware of all of these potential defect sources.

3.5.4.1 **Conventional Classification System.** For many years, it has been customary to classify discontinuities according to their source or origin in the various stages of metal production, fabrication, and use:

- Inherent: Produced during solidification from the liquid state.
- Processing: Primary.
- Processing: Secondary, or finishing.
- Service.

A discussion of each class with detailed examples is given below.

3.5.4.1.1 **Inherent Discontinuities.** This group of discontinuities is present as the result of its initial metal solidification from the molten state, before any of the operations to forge or roll it into useful sizes and shapes have begun. The names of these inherent discontinuities are given and their sources described below.

3.5.4.1.1.1 **Pipe.** As the molten steel which has been poured into the ingot mold cools, solidifies first at the bottom and walls of the mold. Solidification progresses gradually upward and inward. The solidified metal occupies a somewhat smaller volume than the liquid, so there is a progressive shrinkage of volume as solidification continues. The last metal to solidify is at the top of the mold, but due to shrinkage there is not enough metal to fill the mold completely, and a depression or cavity is formed. This may extend quite deeply into the ingot (Figure 3-46). After early breakdown of the ingot into a bloom, this shrink cavity is cut away or cropped. If this is not done completely before final rolling or forging into shape, the unsound metal will show up as voids called "pipe" in the finished product. Such internal discontinuities, or pipe, are obviously undesirable for most uses and constitute a true defect. Special devices ("hot tops") and special handling of the ingot during pouring and solidification can control the formation of these shrink cavities.

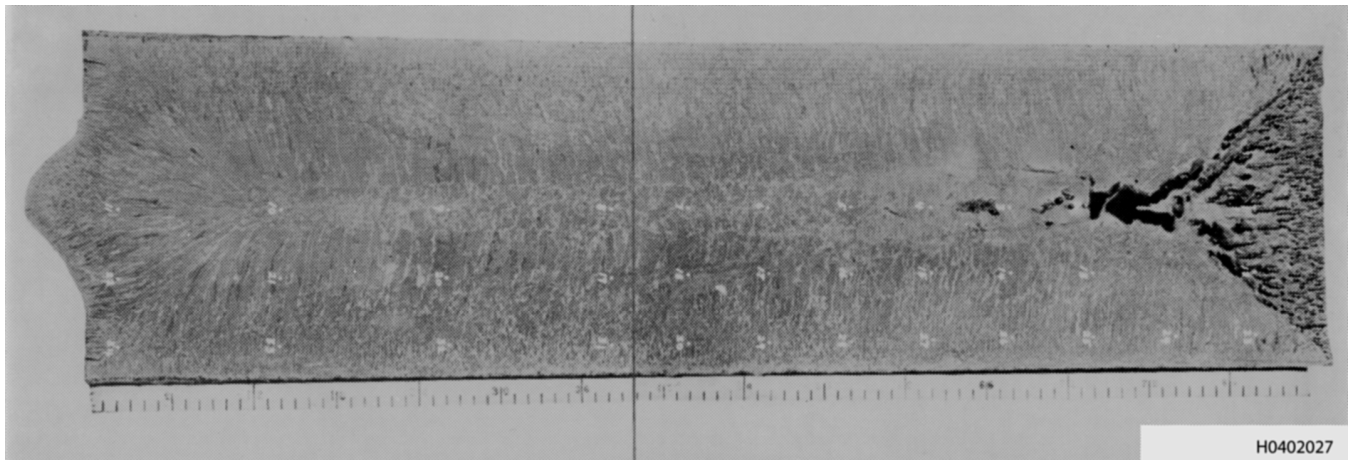


Figure 3-46. Cross-Section of Ingot Showing Shrink Cavity

3.5.4.1.1.2 **Blowholes.** As the molten metal in the ingot mold solidifies there is an evolution of various gases. These gas bubbles rise through the liquid and a small percentage escape. The remainder is trapped as the metal freezes. Most of these, usually small, will appear near the surface of the ingot; some often large, will be deeper in the metal, especially near the top of the ingot. Many of these blowholes are clean on the interior and are fused shut into sound metal during the first rolling or forging of the ingot, but some near the surface may have become oxidized and do not fuse. These may appear as seams in the rolled product. Those deeper in the interior, if not fused in the rolling, may appear as laminations.

3.5.4.1.1.3 **Segregation.** Another action that takes place during the solidification is the tendency for certain elements in the metal to concentrate in the last-to-solidify liquid, resulting in an uneven distribution of some of the chemical constituents in the ingot. Various means have been developed to minimize this tendency, but, if for any reason, severe segregation does occur,

the difference in permeability of the segregated areas may produce magnetic particle indications. Segregation can adversely affect physical properties as well as contribute to the formation of defects later in the processing cycle.

3.5.4.1.1.4 Nonmetallic Inclusions. Nonmetallic inclusions are usually oxides, sulfides, or silicates. They can be introduced by the use of dirty raw materials, crucibles, or rods. Other contributing factors can be faulty linings and poor pouring practices. The inclusions can form stringers during subsequent rolling operations. These stringers can affect the physical properties of the materials and are usually considered defects. An example of an indication of nonmetallic inclusions is shown ([Figure 3-47](#)).

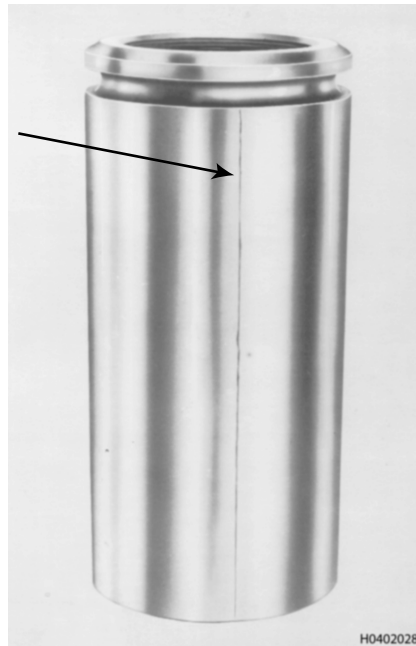


Figure 3-47. Magnetic Particle Indication of a Subsurface Stringer of Nonmetallic Inclusions

3.5.4.1.1.5 Internal Fissures. Because of the stresses setup in the ingot as the result of shrinkage during cooling, internal ruptures may occur, this may be quite large. Since air does not reach the surfaces of these internal bursts, they may be fused during rolling or other forming operations and leave no discontinuity. If there is an opening from the fissure to the surface, however, air will enter and oxidize the surfaces. In this case, fusion does not occur and they will remain in the finished product as discontinuities.

3.5.4.1.1.6 Scabs. When liquid steel is first poured into the ingot mold, there is considerable splashing or spattering up and against the cool walls of the mold. These splashes solidify at once and become oxidized. As the molten steel rises and the mold become filled, these splashes will be reabsorbed to a large extent into the metal. But in some cases they will remain as scabs of oxidized metal adhering to the surface of the ingot. These may remain and appear on the surface of the rolled product. If they do not go deeply into the surface, they may not constitute a defect, since they may be removed by machining. This condition is illustrated ([Figure 3-48](#)) on a rolled bloom.

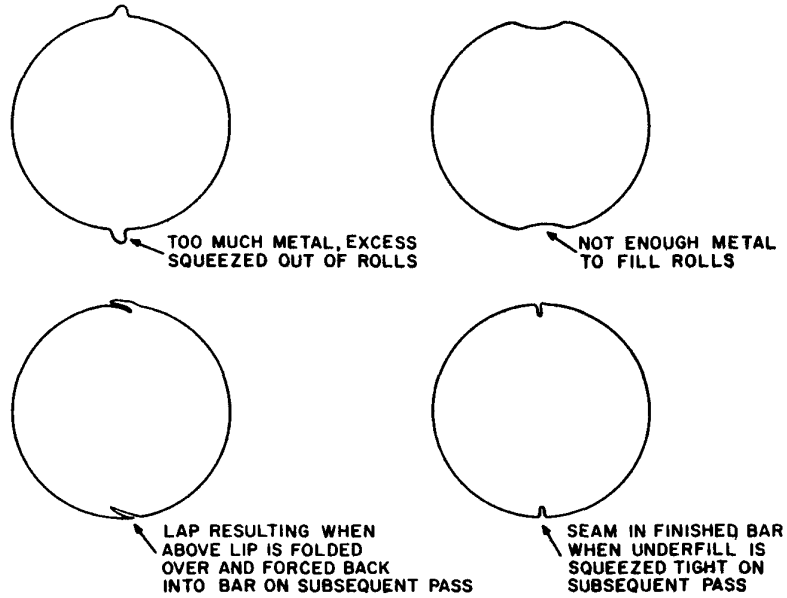


Figure 3-48. Scabs on the Surface of a Rolled Bloom

3.5.4.1.1.7 Ingot Cracks. Surface cracking of ingots occurs due to surface stresses generated during cooling of the ingot. They may be either longitudinal, transverse, or both. As the ingot is formed into billets by rolling, these cracks form long seams. Inspection of billets for seams of this type with magnetic particles is now common practice in modern mills. Detection at this point permits removal of the seams by flame scarfing, chipping, or grinding without waste of good metal. If not removed before further rolling, these seams appear greatly elongated on finished bars and shapes, often making them unsuitable for many purposes.

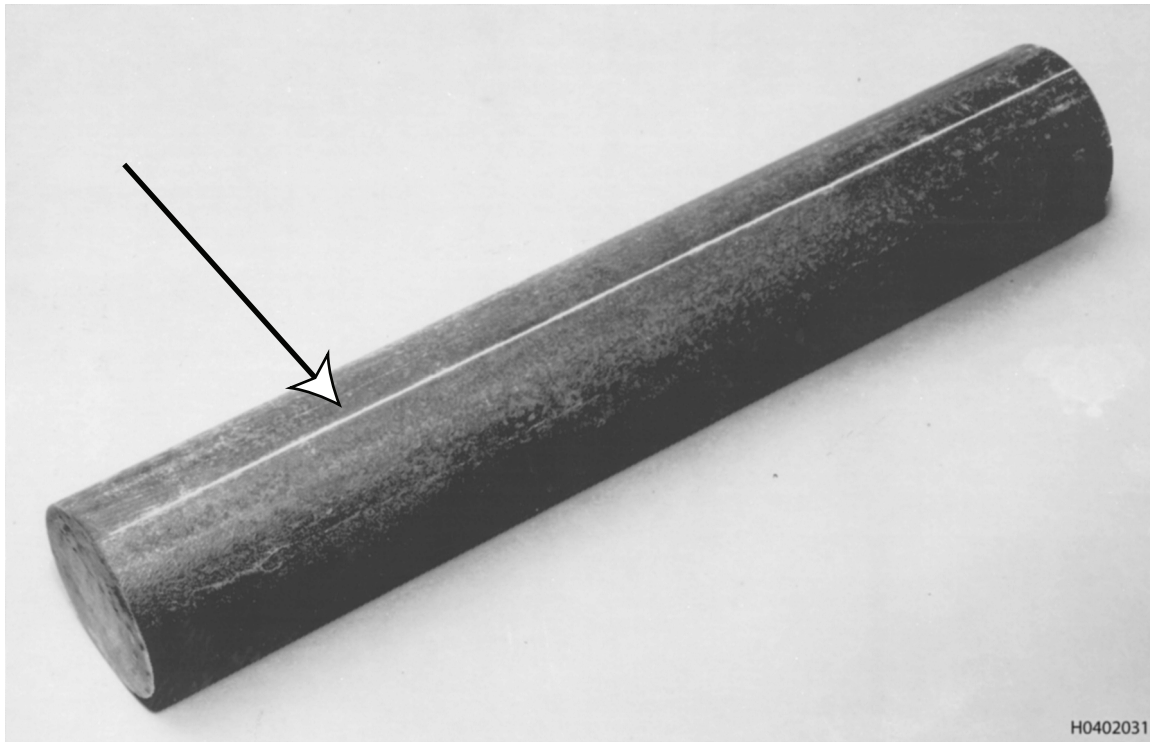
3.5.4.1.2 Primary Processing Discontinuities. When steel ingots are worked down into usable sizes and shapes such as billets and forging blanks, some of the above described inherent defects may appear, but the rolling and forging processes may also introduce discontinuities that may constitute defects. Primary processes are those which work the metal down by either hot or cold deformation into useful forms such as bars, rod and wire, and forged shapes. Casting is another process usually included in this group. Even though it starts with molten metal it results in a semi-finished product. Welding is included for similar reasons. A description of the discontinuities that can be introduced by these primary processes follows:

3.5.4.1.2.1 Seams. Seams in rolled bars or drawn wire are usually highly objectionable. As previously described, seams may originate from ingot cracks. Conditioning of the billet surfaces by scarfing, grinding, or chipping can eliminate the cracks before final rolling is performed, but seams can be introduced by the rolling or drawing processes themselves. Laps can occur in the rolling of the ingot into billets as the result of overfilling the rolls. This produces projecting fins, which on subsequent passes are rolled into the surface of the billet or bar. In similar fashion, under-fills in the rolling process may on subsequent passes be squeezed to form a seam, which often runs the full length of the bar. Seams derived from laps will usually emerge to the surface of the bar at an acute angle. Seams derived from the folds produced by an under-filled pass are likely to be more nearly normal to the surface of the bar. Seams or die marks may also be introduced in the drawing process due to defective dies. Such seams may or may not make the product defective. For some purposes, such as springs or bars for heavy upsetting, the most minute surface imperfections (or discontinuities) are cause for rejection. For others, where machining operations are expected to remove the outer layers of metal, shallow seams will be machined off [Figure 3-49](#) and [Figure 3-50](#).



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Figure 3-49. How Laps and Seams Are Produced from Overfills and Under-Fills



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Figure 3-50. Magnetic Particle Indication of a Seam on a Bar

3.5.4.1.2.2 Laminations. Laminations in rolled plate or strip are formed when blowholes or internal fissures are not fused during rolling, but are enlarged and flattened into sometimes quite large areas of horizontal discontinuities ([Figure 3-51](#)). Laminations may be detected by magnetic particle testing on the cut edges of plate. The laminations do not give indications on plate or strip surfaces since they are internal and parallel to the surface. Ultrasonic mapping techniques are used to define them.

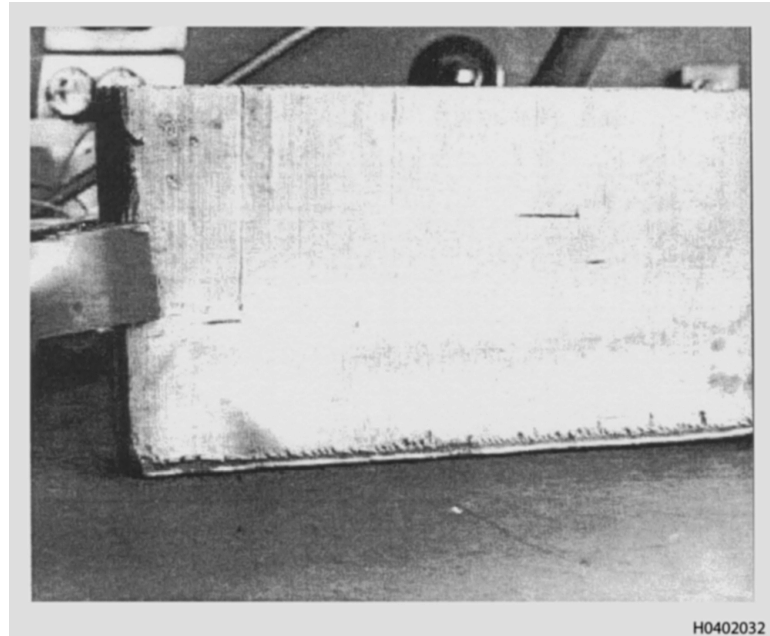


Figure 3-51. Magnetic Particle Indications of Laminations Shown on Flame-Cut Edge of Thick Steel Plate

3.5.4.1.2.3 Cupping. This is a condition created in drawing or extruding when the interior of the metal does not flow as rapidly as the surface. Segregation in the center of the metal usually contributes to this occurrence. The result is a series of internal ruptures that are severe defects whenever they occur. They may be indicated with magnetic particles if the ruptures are large and are near the surface of the part. The cupping problem can be minimized by changing die angles ([Figure 3-52](#)).

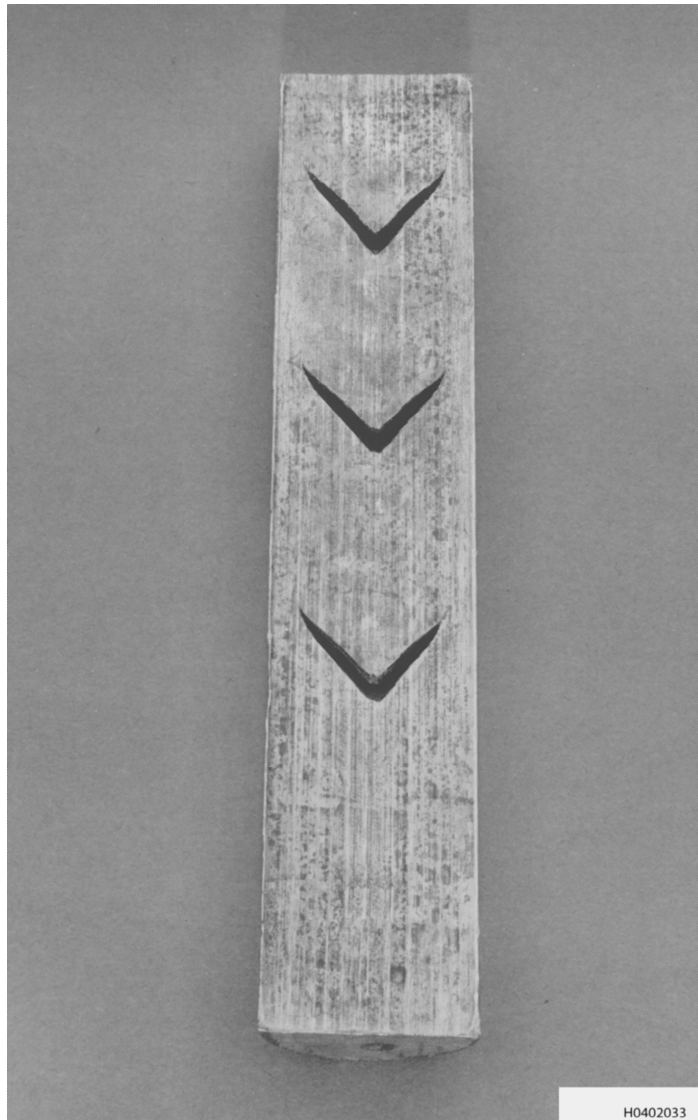
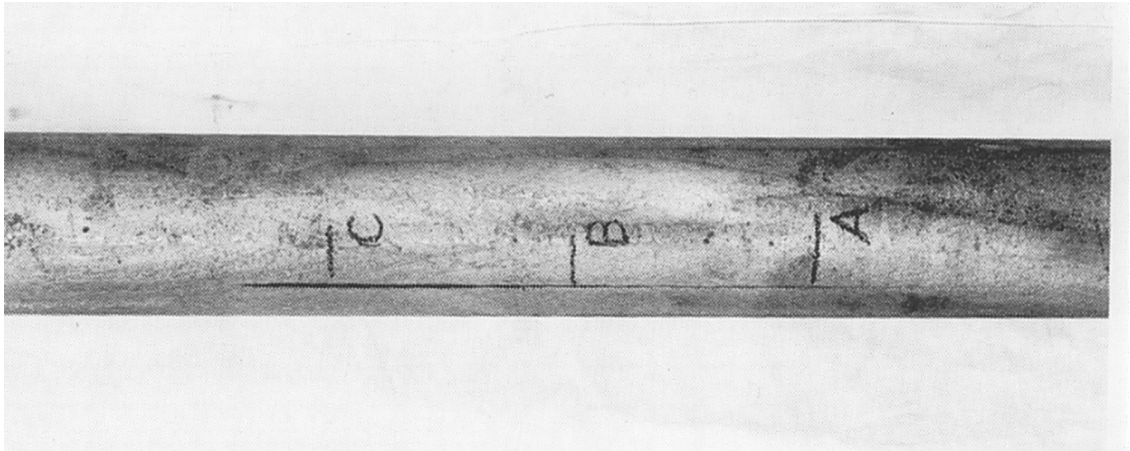


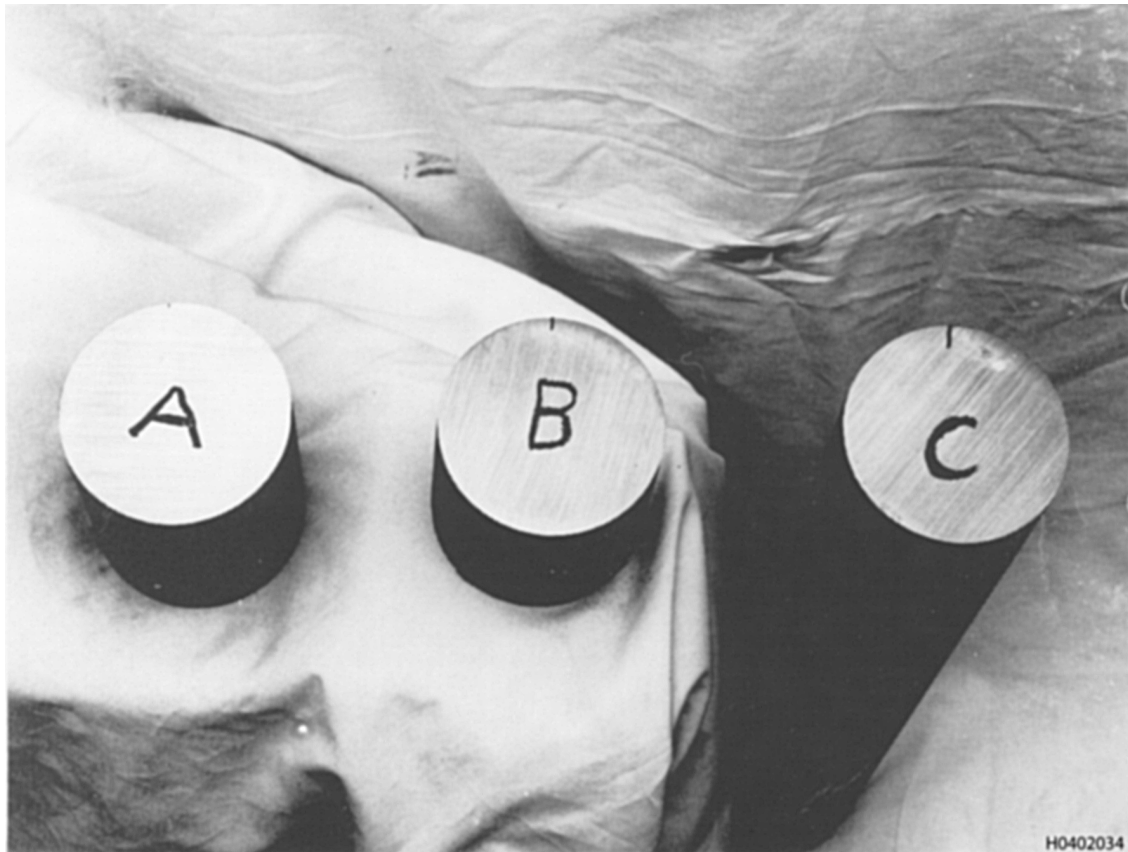
Figure 3-52. Section Through Severe Cupping in a 1 3/8-Inch Bar

3.5.4.1.2.4 Cooling Cracks. When alloy and tool steel bars are rolled and subsequently run out onto a bed or table for cooling, stresses may be set up due to uneven cooling, which can be severe enough to crack the bars. Such cracks are generally longitudinal, but not necessarily straight. They may be quite long and usually vary in depth along their length. The magnetic particle indications of such a crack are shown ([Figure 3-53](#)), along with sections through the crack at three points to illustrate the variation in crack depth. The magnetic particle indication varies in intensity, being heavier at points where the crack is deepest.

- Surface Indications.
- Cross-Section Showing Depth.



(a) Surface Indications



(b) Cross Section Showing Depth

Figure 3-53. Magnetic Particle Indications of Cooling Cracks in an Alloy Steel Bar

3.5.4.1.2.5 Hydrogen Flakes. Flakes are internal ruptures that may occur in steel as the result of internal stresses from metallurgical changes and decreased solubility of hydrogen from excessively rapid cooling. Flakes usually occurring in fairly heavy sections and on certain alloys are more susceptible than others. Magnetic particle indications of flakes exposed on a machined surface are shown ([Figure 3-54](#)). Since these ruptures are deep in the metal, usually half way or more from the surface to the center of the section, they will not be shown by magnetic particle testing on the original surface of the part.

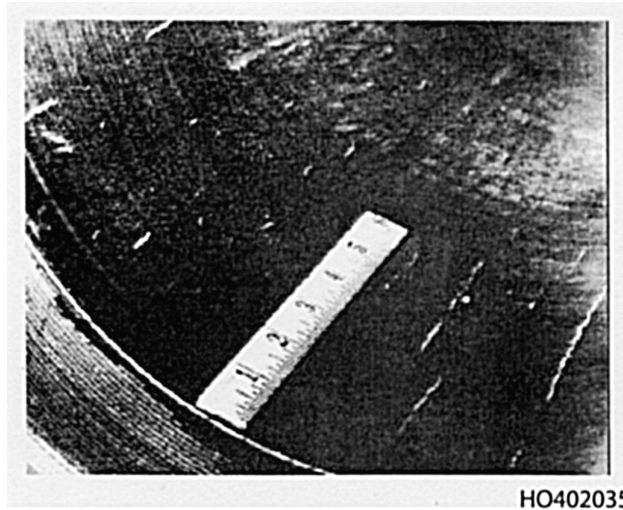


Figure 3-54. Magnetic Particle Indications of Flakes in a Bore of a Large Hollow Shaft

3.5.4.1.2.6 Forging Bursts. When steel is worked at too high a temperature, it is subject to cracking or rupturing. Too rapid or too severe a reduction of section can also cause bursts or cracks. Such ruptures may be internal bursts, or they may be cracks at the surface. Cracks at the surface are readily found by magnetic particle testing. If interior, they are usually not shown except when they have been exposed by machining ([Figure 3-55](#)).

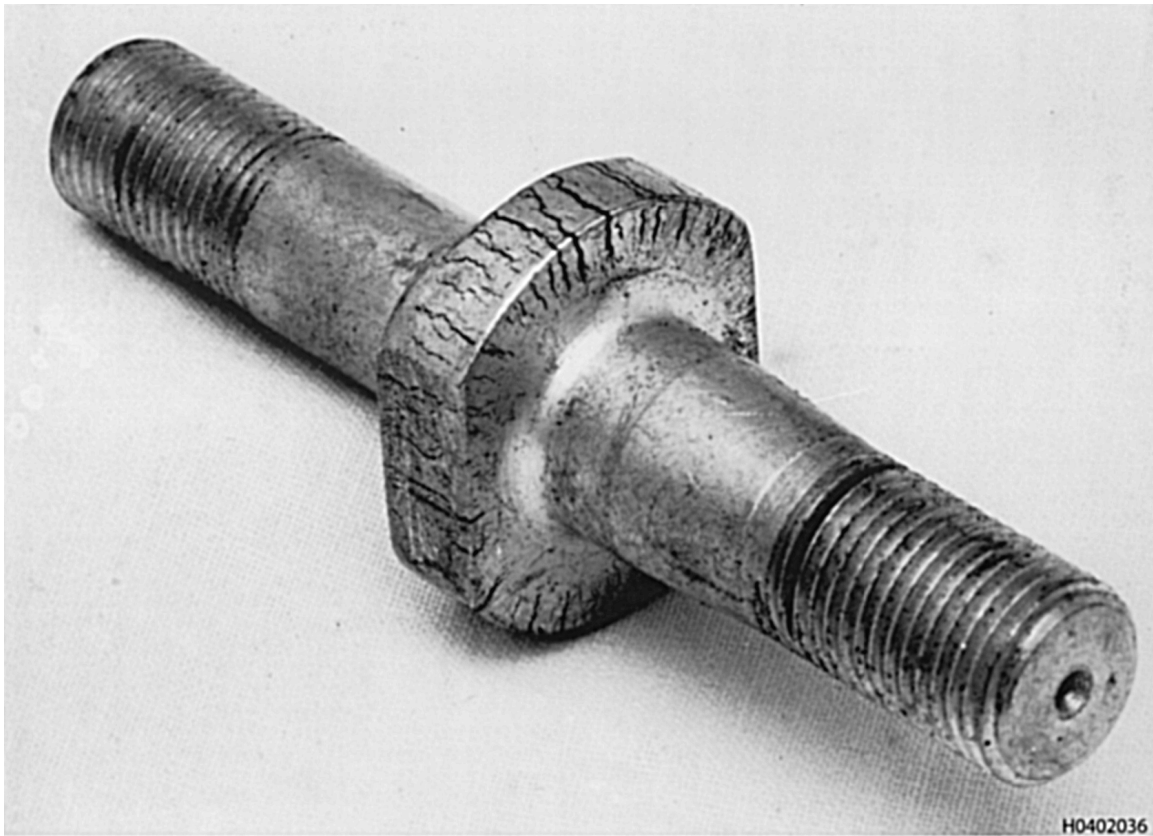


Figure 3-55. Magnetic Particle Indications of Forging Cracks or Bursts in an Upset Section, Severe Case

3.5.4.1.2.7 Forging Laps. As the name implies, forging laps or folds are formed when, in the forging operation, improper handling of the blank in the die causes the metal to flow so as to form a lap, which is later squeezed tight. Since it is on the surface and is oxidized, this lap does not weld shut. This type of discontinuity is sometimes difficult to locate because it may be open at the surface and fairly shallow, and often may lie at only a very slight angle to the surface. In some unusual cases, it also may be solidly filled with magnetic oxides ([Figure 3-56](#) and [Figure 3-57](#)).

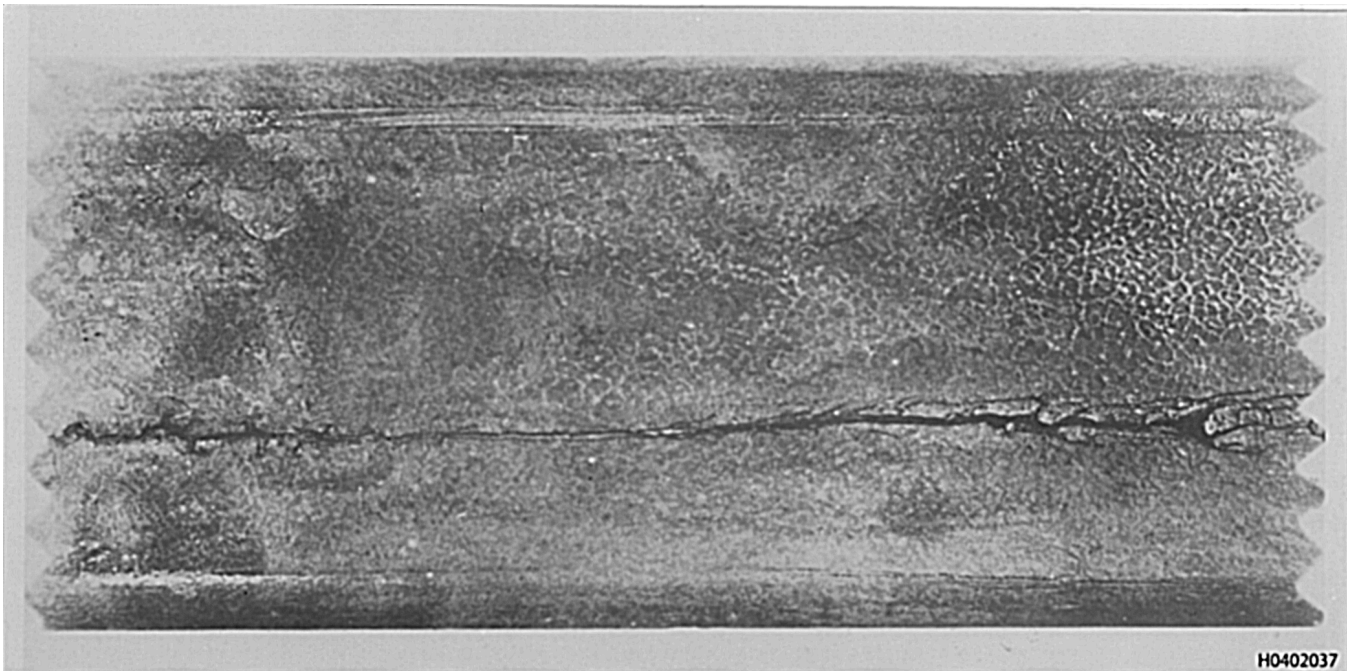


Figure 3-56. Surface of a Steel Billet Showing a Lap

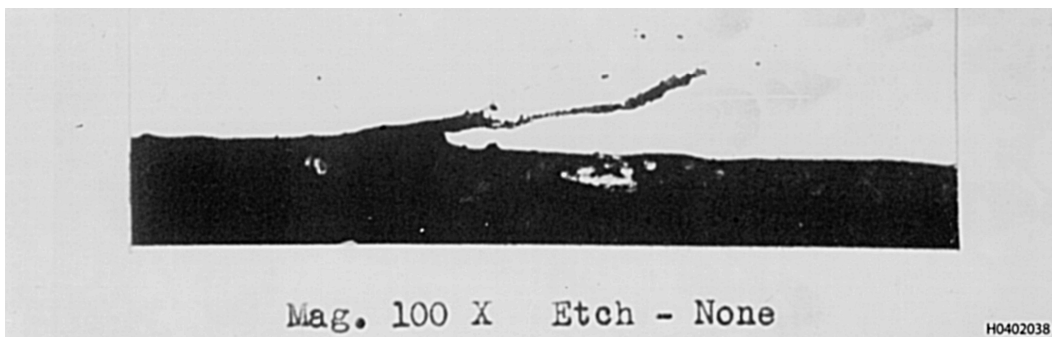


Figure 3-57. Cross Section of a Forging Lap (Magnified 100X)

3.5.4.1.2.8 Burning. Overheating of forgings to the point of incipient melting, which results in a condition that renders the forging unusable, in most cases is referred to as burning. However, the real source of the damage is not oxidation, but the material becoming partially liquefied due to the heat at the grain boundaries. Burning is a serious defect, but is not generally shown by magnetic particle testing.

3.5.4.1.2.9 Flash-Line Tears. Cracks or tears along the flash line of forgings are usually caused by improper trimming of the flash. If shallow, they may "clean up" during machining, otherwise they are considered defects. Such cracks or tears can easily be found by magnetic particles ([Figure 3-58](#)).

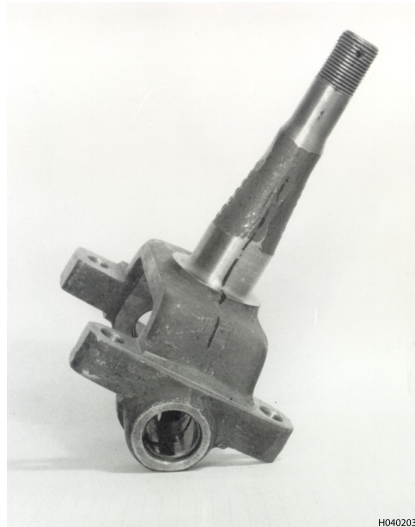


Figure 3-58. Magnetic Particle Indication of Flash Line Tear in a Partially Machined Automotive Spindle Forging

3.5.4.1.2.10 Casting Defects. Steel and iron castings are subject to a number of defects which magnetic particle testing can easily detect. Surface discontinuities are formed in castings due to stresses resulting from cooling and are often associated with changes in the cross section of the part. These may be hot tears or they may be shrinkage cracks that occur as the metal cools down. Sand from the mold can be trapped by the hot metal and form sand inclusions on or near the surface of castings. Gray iron castings may be quite brittle, and can be cracked by rough handling ([Figure 3-59](#)).



Figure 3-59. Magnetic Particle Indications of Defects in Castings

3.5.4.1.2.11 Weld Defects. A variety of discontinuities may be formed during welding. Some are at the surface and some are in the interior of the weldment. Some of the defects peculiar to weldments are lack of penetration, lack of fusion, undercutting, cracks in the weld metal, crater cracks, cracks in the heat affected zone, etc.

3.5.4.1.3 **Secondary Processing or Finishing Discontinuities.** In this group are those discontinuities associated with the various finishing operations after the part has been rough-formed by rolling, forging, casting, or welding. Discontinuities may be introduced by machining, heat treating, grinding, and similar processes. These are described below:

3.5.4.1.3.1 **Machining Tears.** These are caused by dragging of the metal under the tool when it is not cutting cleanly. Soft and ductile low carbon steels are more susceptible to this kind of damage than are the harder, higher carbon or alloy types. Machining tears are surface discontinuities and are readily found with magnetic particles.

3.5.4.1.3.2 **Heat Treat Cracks.** When steels are heated and quenched to produce desired properties for strength or wear, cracking may occur if the operation is not correctly suited to the material and shape of the part ([Figure 3-60](#)). Most common are quench cracks, caused when parts are heated to high temperatures and then suddenly cooled by immersing them in some cool medium, which may be water, oil, or even air. Such cracks often occur at locations where the part changes cross section or at fillets or notches in the part. The edges of keyways and the roots of splines or threads are likely spots for quench cracks to occur. Cracks may also result from too rapidly heating the part, which may cause uneven expansion at changes of cross section or at corners where heat is absorbed more rapidly than in the body of the piece. Corner cracking may also occur during quenching, because of more rapid heat loss at such locations. Heat treat cycles can be designed to minimize or eliminate such cracking; but for critical parts, testing with magnetic particle is a safety measure usually applied, since such cracks are serious and easily detectable.



Figure 3-60. Magnetic Particle Indications of Quenching Cracks Shown With Dry Powder

3.5.4.1.3.3 **Straightening Cracks.** The process of heat treating often causes some warping of the part due to non-uniform cooling during quenching. A hardened shaft, for example, may come from the heat treat operation not quite straight. In many cases, these can be straightened in a press, but if the amount of bend required is too great or if the shaft is too brittle, cracks may be formed. Again, these are very readily found with magnetic particles.

3.5.4.1.3.4 **Grinding Cracks.** Surface cracking of hardened parts as the result of improper grinding is frequently a source of trouble. Grinding cracks are essentially thermal cracks. They are caused by stresses set up by local heating under the grinding wheel. They are avoidable by using proper wheels, cuts, and coolants. They are sharp surface cracks and they are easily detected with magnetic particle inspection. Such surfaces usually crack severely and extensively, as illustrated in [Figure 3-61](#) and [Figure 3-62](#).

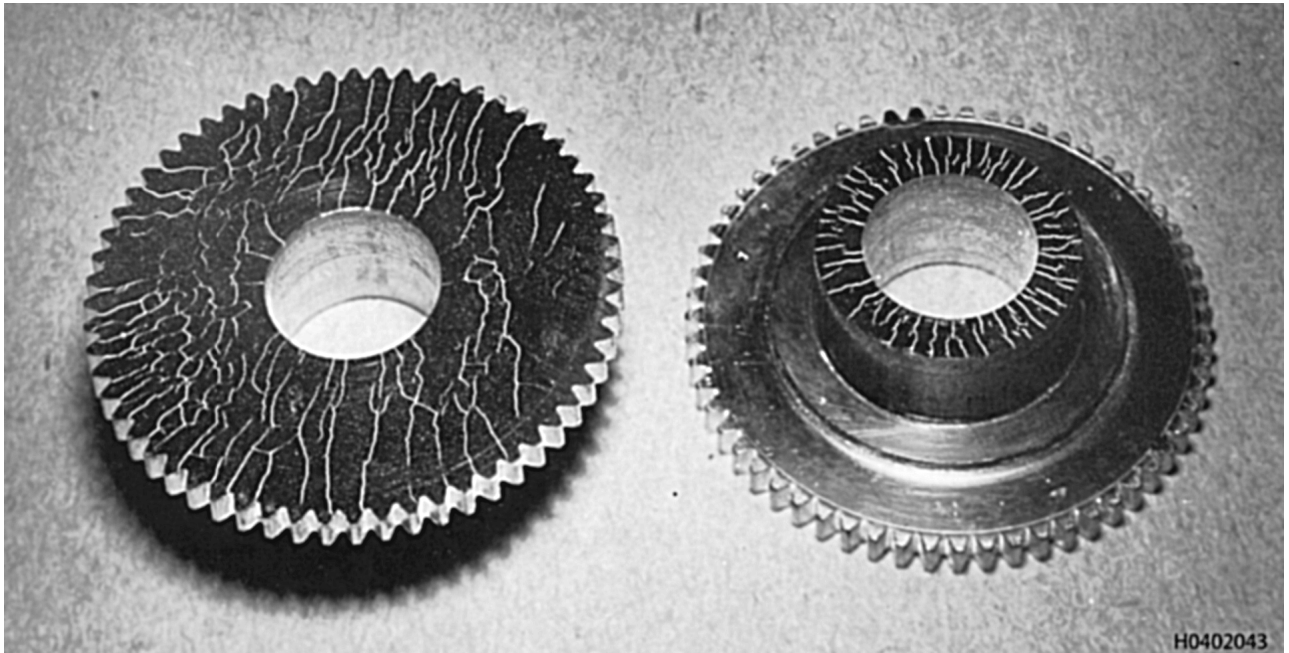


Figure 3-61. Fluorescent Magnetic Particle Indications of Typical Grinding Cracks

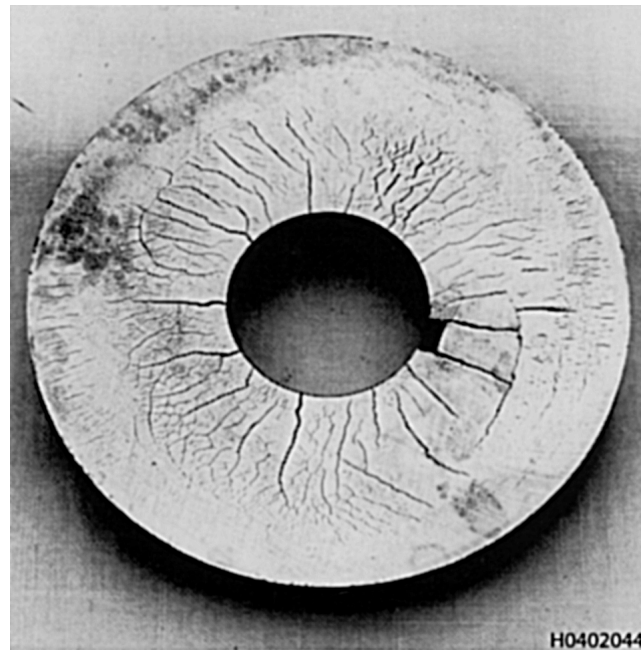


Figure 3-62. Magnetic Particle Indications of Grinding Cracks in a Stress-Sensitive, Hardened Surface

3.5.4.1.3.5 Etching and Pickling Cracks. Hardened or cold worked parts, that contain high internal and external residual stresses, may crack if they are pickled or etched in acid. Acid attack of the surface layers of the metal gives the internal stress a chance to be relieved by the formation of a crack. Before this action was fully understood, the heat treatment of the part was often blamed for the cracking. The heat treat operation did, however, deserve some of the blame by leaving the part with high residual stresses.

3.5.4.1.3.6 Plating Cracks. Plating can introduce high residual stresses at the plated surface and thus create the potential for cracking. The hot galvanizing process itself may also produce cracks in surfaces containing residual stresses by the penetration of hot zinc into the grain boundaries. Copper penetration during brazing may result in similar cracking if the parts contain residual stress ([Figure 3-63](#)).

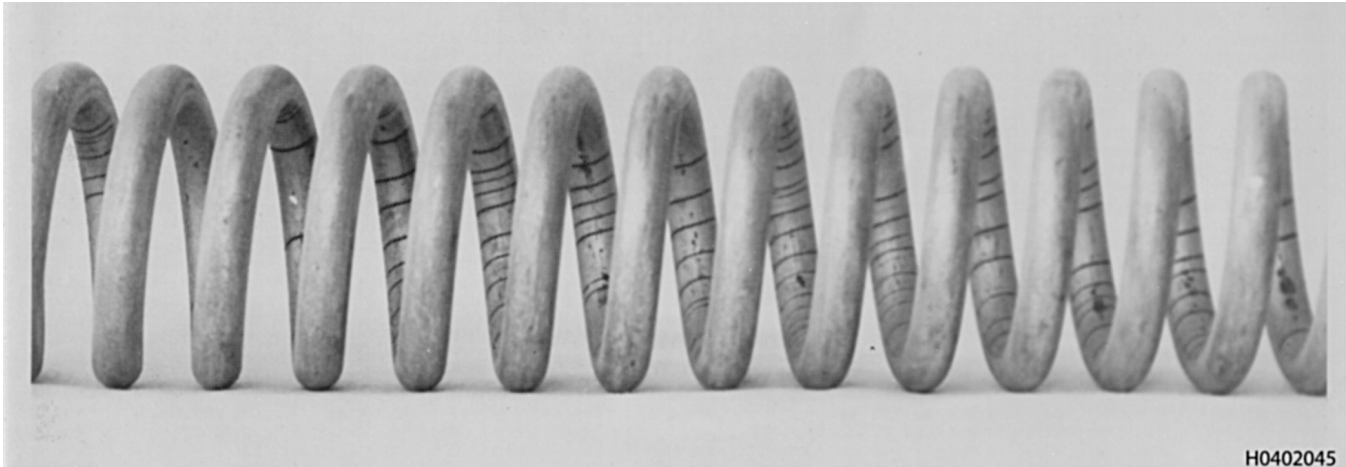


Figure 3-63. Magnetic Particle Indications of Plating Cracks

3.5.4.2 Service Cracks.

CAUTION

When performing magnetic particle inspection on landing gear parts, the paint SHALL be removed. Some landing gear components are vulnerable to stress-corrosion cracking and are cadmium plated for their protection. Thus, the primer layer MAY remain on the part. Damage to the cadmium plating SHALL be avoided.

The fourth major classification of discontinuities comprises those formed or produced after all fabrication has been completed and the part has gone into service. The objective of magnetic particle testing to locate and eliminate discontinuities during fabrication is to put the part into service free from defects. However, even when this is accomplished, failures in service still occur as a result of cracking caused by service conditions.

3.5.4.2.1 Fatigue Cracks. Fatigue stress will eventually cause cracks, and finally fracture. Fatigue cracks, even very shallow ones, can readily be found with magnetic particles ([Figure 3-64](#) and [Figure 3-65](#)).

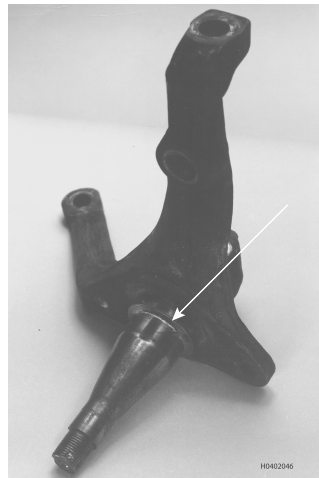


Figure 3-64. Magnetic Particle Indication of a Typical Fatigue Crack

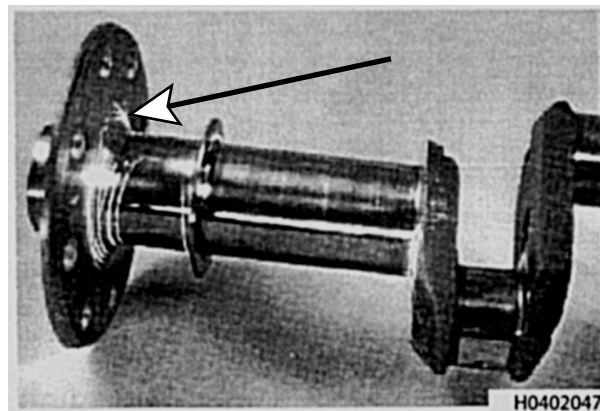


Figure 3-65. Fluorescent Magnetic Particle Indications of Cracks in Crankshaft of Small Aircraft Engine Damaged in Plane Accident

3.5.4.2.2 Stress-Corrosion Cracks. Parts under either residual or applied tensile stress and exposed to a corrosive environment may develop stress-corrosion cracking. The primary role of corrosion in this cracking mode is to produce hydrogen. The hydrogen migrates to the tip of a stress-corrosion crack where its presence increases the stresses at the tip, thus driving the crack even deeper. When corrosion is added to a fatigue-producing service condition, this type of service failure is called corrosion fatigue.

3.5.4.2.3 Overstressing. Parts stressed beyond the level for which they were designed can crack or break. Such overstressing may occur as the result of an accident, a part may become overloaded due to some unusual or emergency condition not anticipated by the designer, or a part may be loaded beyond its strength because of the failure of some related member of the structure. After complete failure has occurred, magnetic particle testing obviously has no application with regard to the fractured part. However, other parts of the assembly, that may appear undamaged, could have been overstressed during the accident or overloaded from other causes. Examination by magnetic particle testing is usually carried out in such cases to determine whether any cracks have actually formed.

3.5.4.3 Other Sources of Discontinuities. In this section, an attempt has been made to familiarize the reader with most of the common sources of discontinuities that can occur in iron and steel. Actually, the list given here is incomplete, but the inspector working with magnetic particle testing will encounter these discontinuities more frequently than those from less common conditions. The inspector will often have the metallurgical laboratory of a support organization available for consultation, and the metallurgist will usually be able to assign a cause to an indicated discontinuity and assess its importance.

3.5.5 Non-Relevant Indications.

3.5.5.1 Nature and Type.

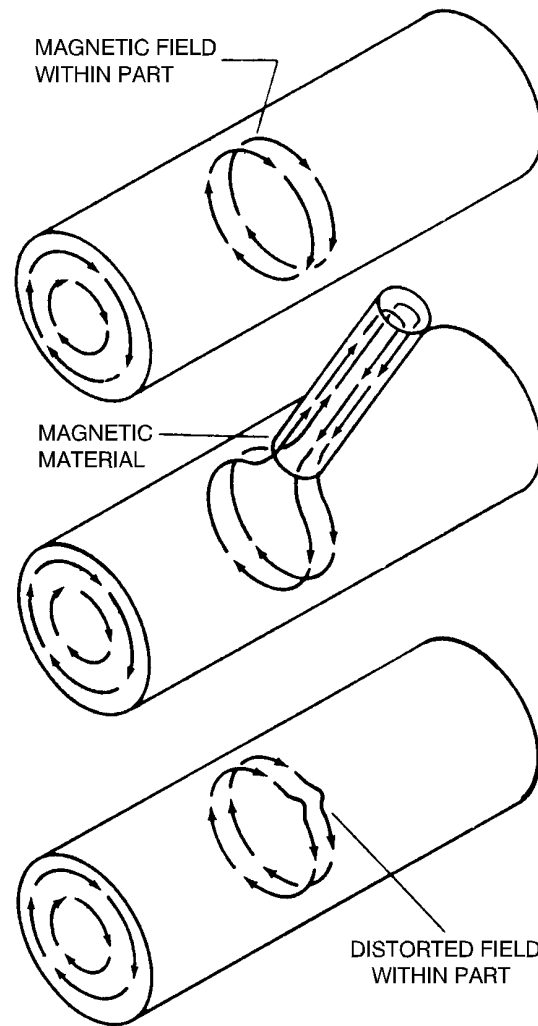
NOTE

It is easier to distinguish between relevant and non-relevant indications when using fluorescent rather than visible magnetic particles.

It is possible to magnetize parts of certain shapes in such a way that magnetic leakage fields are created even though there is no discontinuity in the metal at that point. Such indications are sometimes called erroneous indications or false indications. They should be called "non-relevant indications" since they are actually caused by distortion of the magnetic field. They are true indications, but since there is no unintentional interruption of the material, they do not affect the usefulness of the part. It is important for the inspector to know how and why these non-relevant indications are formed and where they can occur.

3.5.5.2 Classes of Non-Relevant Indications.

3.5.5.2.1 Magnetic Writing. This is a condition caused by a piece of steel rubbing against another piece of steel that has been magnetized. Since either or both pieces contain some residual magnetism, the rubbing or touching creates magnetic poles at the points of contact. These local magnetic poles are usually in the form of a line or scrawl, and for this reason the effect is referred to as magnetic writing. In [Figure 3-66](#) the part in the top view is magnetized with a circular field. If another part made of magnetic material is rubbed against or comes into contact with the magnetized part, as in the second view, a weak field will be induced into the smaller part. After the smaller part has been removed, the circular field in the original part will be altered or distorted to some extent, as shown in the bottom view. Since there is no force to change the direction of the altered field, there will be some leakage at the point of distortion that will attract magnetic particles.



H0402048

Figure 3-66. Creation of Magnetic Writing

3.5.5.2.2 Longitudinal Magnetization. When a part is longitudinally magnetized in a coil, there are always magnetic poles at the ends of the piece. Magnetic material such as chips, magnetic powder, or paste will be attracted to these poles. The same situation occurs when a yoke is used to create a magnetic field; poles are induced on the part in the areas where the yoke touches the part.

3.5.5.2.3 Cold Working. Cold working consists of changing the size or shape of a metal part without raising its temperature before working. When a bent nail is straightened by a carpenter with a hammer, the nail is being cold worked. Cold working usually causes a change in the permeability of the metal where the change in size or shape occurs. The boundary of the area of changed permeability may attract magnetic particles when the part is magnetized.

3.5.5.2.4 Hard or Soft Spots. If there are areas of a part which have a different degree of hardness than the remainder of the part, these areas will usually have a different permeability. When a part with such areas of different permeability is inspected with magnetic particle inspection, the boundaries of the areas may create local leakage fields and attract magnetic particles to form indications.

3.5.5.2.5 High Temperature Exposure.

3.5.5.2.5.1 Boundaries of Heat Treated Sections. Heat treating a part consists of heating it to a high temperature and then cooling it under controlled conditions. The cooling may be relatively rapid or it may be done to decrease the hardness or the grain size of the metal by varying the temperature and the rate of cooling. On a cold chisel, the point is hardened to cut better and to hold an edge. The head of the chisel, which is the end struck by the hammer, is kept softer than the cutting edge so it won't shatter and break. The edge of the hardened zone frequently creates a leakage field when the chisel is inspected with magnetic particle inspection.

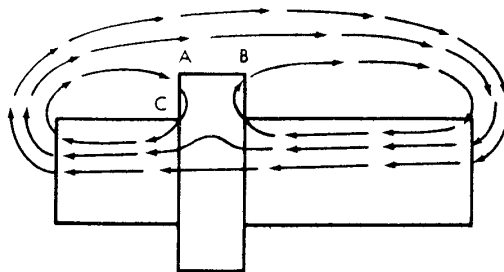
3.5.5.2.5.2 Delta Ferrite.

NOTE

Delta Ferrite is brittle and has historically been considered a defect in applications such as aircraft exposed to tensile and cyclic loading. While the presence of delta ferrite does not indicate an actual defect, such a region would be a preferential crack initiation area.

Delta Ferrite is a ferromagnetic phase of steel that occurs at elevated temperatures. This phase primarily occurs at normal temperatures because of rapid cooling after prolonged exposure to high temperatures. A concentrated region of delta ferrite may cause non-relevant indications along the region's boundary due to the magnetic disturbance caused by its presence.

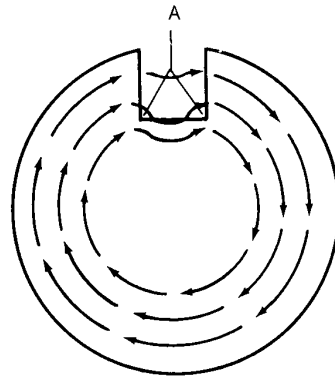
3.5.5.2.6 Abrupt Changes of Section. Where there are abrupt changes in section (e.g., thickness of a magnetized part), the magnetic field may be said to expand from the smaller section to the larger. Frequently, this creates local poles due to magnetic field leakage or distortion. If a part, as shown in [Figure 3-67](#), is magnetized in a coil, poles are setup at each end and some leakage occurs at A and B. Also, the change of section at C is quite abrupt and there may be a leakage across this corner as shown. These leakage fields will attract magnetic particles, thereby creating an indication. The indications formed at A and B are usually very easily interpreted; that at C may be more difficult to recognize as being non-relevant. If the indication is continuous around the shaft, it should be suspected as being caused by the shape of the part rather than by a discontinuity. The non-relevant indication at C will usually be "fuzzy" like an indication, which is produced by a defect beneath the surface. If there is a crack or discontinuity in that area, it will usually produce a sharper indication and it probably will not run completely around the part.



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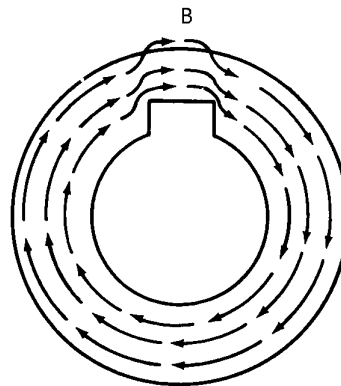
Figure 3-67. Local Poles Created by Shape of Part

3.5.5.2.6.1 On parts with keyways, a circular magnetic field can also setup non-relevant indications as in [Figure 3-68](#). Particle accumulations may occur at A where there are leakage fields. A keyway on the inside of a hollow shaft may also create indications on the outside, as indicated at area B in [Figure 3-69](#).



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Figure 3-68. Concentration of Field in a Keyway



H0402051

Figure 3-69. External Leakage Field Created by an Internal Keyway

3.5.5.2.6.2 The gear and spline shown in [Figure 3-70](#) were magnetized circularly by passing current through a central conductor. The reduced cross section created by the spline ways constricts the magnetic lines of force and some of them break the surface on the outside diameter. Particles gather where the magnetic lines of force break through the surface, thereby creating indications. A non-relevant indication is shown ([Figure 3-71](#)) on the underside of a bolt head. The slot in the head causes the indication here.

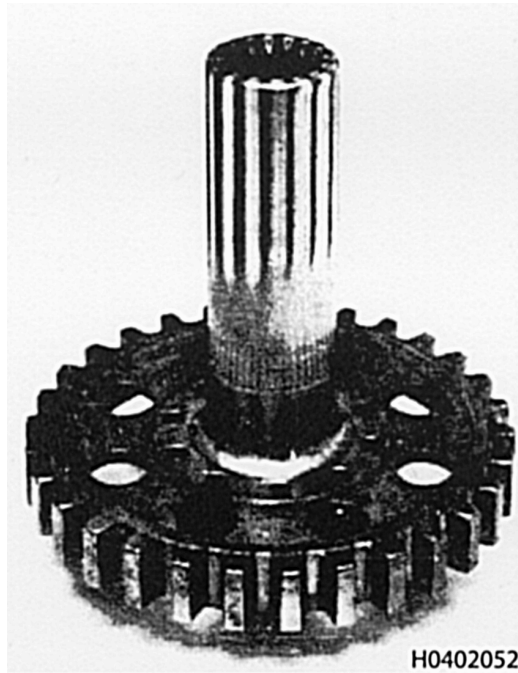


Figure 3-70. Non-Relevant Indications of Shaft Caused by Internal Spline

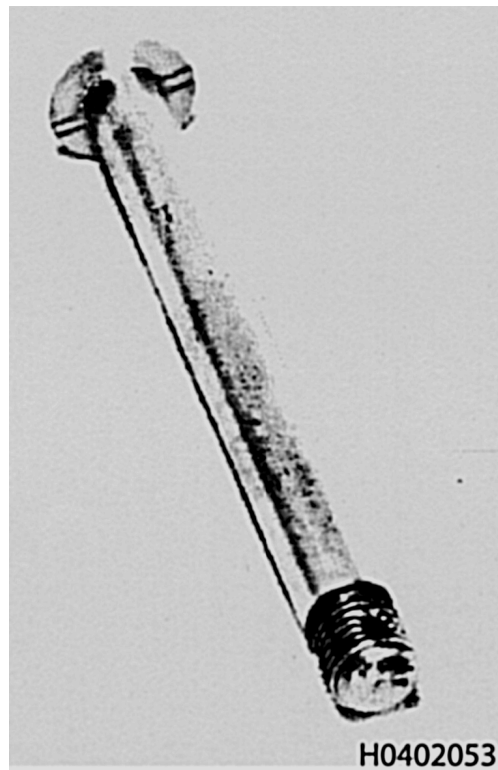


Figure 3-71. Non-Relevant Indications Under the Head Created by Slot in Bolt

3.5.6 Interpretation and Elimination of Non-Relevant Indications.

3.5.6.1 Interpretation. It may first appear to the inspector that some types of non-relevant indications discussed and illustrated in the preceding material would be difficult to recognize and interpret. For example, the non-relevant indications shown in [Figure 3-70](#) and [Figure 3-71](#) may look like indications of subsurface discontinuities. However, there are several characteristics of non-relevant indications that will enable the inspector to recognize them in the example cited and under most other conditions. These characteristics of non-relevant indications are:

- On all similar parts, given the same magnetizing technique, the indications will occur in the same location and will have identical patterns. This condition is not usually encountered when dealing with real subsurface defects.
- The indications are usually uniform in direction and size.
- The indications are usually "fuzzy" rather than sharp and well defined.
- Non-relevant indications can always be related to some feature of construction or cross section, which accounts for the leakage field creating the indication.

3.5.6.2 Elimination of Non-Relevant Indications. Although non-relevant indications can be recognized in most cases, they do tend to increase the inspection time, and under certain conditions may mask or cover up indications of actual defects. Therefore, it is desirable to eliminate them whenever possible.

3.5.6.2.1 In most cases, non-relevant indications occur when the magnetizing current is higher than necessary for a given part. Consequently, these indications will disappear if the part is demagnetized and reinspected using a sufficiently low magnetizing current. Under most conditions, the value of magnetizing current that is low enough to eliminate non-relevant indications will still be sufficient to produce indications at actual discontinuities. This will be true where the non-relevant indication is magnetic writing, and for several other types, but may not hold where there are abrupt changes of section. It is therefore desirable to determine whether the non-relevant indication was caused by an abrupt change of section before re-inspecting.

3.5.6.2.2 The proper procedure is to demagnetize and reinspect the part using a lower value of magnetizing current, repeating the operation with still lower current if necessary until the non-relevant indications disappear. Care SHALL be taken not to reduce the current below the value required to produce indications of all actual discontinuities. Where there are abrupt changes of section, two inspections may be required:

- a. Conduct the first inspection at fairly low amperage, in order to inspect only the areas at the change in section.
- b. Conduct the second inspection at a higher current value, in order to inspect the remainder of the part.
- c. Another solution is to use AC magnetization for inspection. AC magnetization responds less to changes in cross section than DC magnetization and is acceptable when it is not necessary to inspect for subsurface defects.

3.5.7 Methods of Recording MPI Indications.

3.5.7.1 General. The full value of magnetic particle inspection can be realized only if records are kept of parts inspected and the indications found. As with any inspection, the size and shape of the indication and its location on the part should be recorded along with other pertinent information such as rework performed or disposition. The inclusion of some visible record of the indications on a report makes the report much more complete.

3.5.7.2 Type of Records. The simplest record is a sketch of the part showing location and extent of the indications. On large parts, it may be sufficient to sketch only the critical area. Other types of records include preserving the actual indication on the part (where the part is to be kept for reference), transferring the indication from the part to a record sheet or report, and photographing the indication. These last three methods will be discussed in this section.

3.5.7.3 Preserving Indications on a Part.

3.5.7.3.1 Fixing Indications with Lacquer. One of the advantages of magnetic particle inspection is the indication is formed directly on the part at the exact spot of the magnetic leakage field. This makes it possible to retain the part itself for record purposes, but it is necessary to fix or preserve the indication on the part; so the part can be handled and examined without smudging or smearing the indication. One method of fixing the indication semi-permanently on the part is by using clear lacquer. The part SHALL be dry to do this; if the wet method has been used to develop the indication, the vehicle SHOULD be allowed to evaporate. Normal evaporation can be accelerated by heating the part and is usually sufficient for water; it is also possible to flow on isopropyl alcohol or other solvent that will evaporate rapidly and leave the indication dry on the part. For an oil vehicle, use of a solvent is almost necessary to provide a dry indication in a reasonable time. It is usually desirable to thin out the clear lacquer by adding lacquer thinner. The lacquer should either be sprayed on the part or flowed on since brushing would smear the indication.

3.5.7.3.2 Applying Transparent Tape. It is also possible to preserve an indication on a part by covering it with transparent pressure sensitive tape (such as Scotch brand). This method is not as neat looking as the lacquer method, but it is easier to apply. Before applying the tape, the vehicle used in the wet method SHOULD be removed in the same manner as when using lacquer.

3.5.7.4 Tape Transfers. An accurate record of an indication can be obtained by lifting the particles forming the indication from the part with transparent pressure sensitive tape (such as Scotch brand), and then placing the tape on stiff white paper. The procedure for taking tape transfers is simple and can be accomplished quickly and accurately with a little practice. If a report is being made and it is necessary to duplicate the indication, mount the tape transfer on a sheet of clear plastic and use a standard duplicating process or prepare a photographic negative and contact print. When tape transfers are taken of indications, it is customary to sketch the part and locate the position of the preserved indication on the sketch.

3.5.7.4.1 Dry Particle Tape Transfers. If the indication is formed of dry powder particles, excess powder can be removed from the surface by gently blowing. Use a piece of tape larger than the indication and gently cover the indication with the tape. Gentle pressure should be applied so the adhesive will pick up the particles; do not press too hard or the indication will be flattened too much and the tape may be difficult to remove. Carefully lift the tape from the part and press it onto the record sheet or report. It is easier to remove the tape if a corner of it is not pressed to the part. Leaving a tab for easy removal.

NOTE

Tape preserved indications are usually a little broader than indications on the part because of the flattening effect of the tape.

3.5.7.4.2 Wet Particle Tape Transfers. If the indication is formed of particles used with the wet method, it is necessary to dry the surface of the part prior to applying the tape as described in [Paragraph 3.5.7.4.1.](#)

3.5.7.4.3 Fluorescent Tape Transfers. Tape transfers can be taken of fluorescent particle indications, but there are some disadvantages to the process. Such preserved indications usually must be viewed under UV-A to properly interpret them since the number of particles in the suspension is much less than when using visible particles. Some transparent tape is fluorescent and the fluorescence of the tape may mask the fluorescence of the indication.

3.5.7.5 Alginate Impression Compound Method. The alginate impression compound method of "lifting" magnetic particle indications is a method of securing indications in areas inaccessible and that cannot be viewed with a UV-A lamp.

3.5.7.5.1 Alginates are hydrocolloid polysaccharides derived from seaweed kelp. Compounds such as those used for making dental impressions are based on mixtures of potassium alginate, calcium sulfate, sequestering agents such as sodium phosphate, and fillers such as silica, diatomaceous earth, or calcium carbonate. When the compound is mixed with the correct amount of water it forms a soft paste that sets up to a rubbery solid in three to four minutes. This rubbery material or gel has the property of accurately conforming to and taking an impression of the surface to which it is applied, and also absorbing or lifting traces of particulate material from the surface. This latter property is the basis for its use as an indication lifting material.

3.5.7.5.2 Transferring Indications with Alginate Impression Compound.

- a. Perform the magnetic particle inspection of the area of interest in the usual manner.

- b. The part does not have to be dried before taking an impression.
- c. Using the plastic scoop and water measuring container, follow the directions given on the can of powder and mix the powder with water to obtain a smooth creamy paste.
- d. Transfer the paste immediately to a piece of thin polyethylene film, and then apply the paste to the inspecting area. Gently press against the film to obtain a uniform contact of the paste against the inspection area. Avoid excessive working of the paste to avoid smearing of the indication. The plastic film prevents the paste from sticking to the hand. For cavities such as holes, the paste can be applied without the polyethylene film to form a plug when set.
- e. After the paste has set to a rubbery gel, in about 3 - 4 minutes, gently remove the replica from the metal part and examine under ultraviolet light. The replica may be photographed with ultraviolet light if desired.

3.5.7.6 Photographing Indications. Photographs may also be taken of indications to produce records. Enough of the part should be shown to make it possible to recognize the part and the position of the indication. It is helpful to include in the picture some common object to show the size of the part. Sometimes this can be done with a finger pointing at the indication or by placing a ruler along the part to show relative size. In photographing indications on highly polished parts, care SHALL be taken to avoid highlights or reflections that may hide indications. Taking photographs of fluorescent indications calls for special photographic techniques referenced in the penetrant chapter, [Paragraph 2.5.6.6](#), for additional information.

SECTION VI PROCESS CONTROL OF MAGNETIC PARTICLE INSPECTION

3.6 MAGNETIC PARTICLE PROCESS CONTROL.

3.6.1 Purpose and Scope. This section provides information necessary to ensure a high quality performance for the magnetic particle inspection system. This section discusses the reasons for process control, the use of the Quantitative Quality Indicators to confirm the adequacy of the magnetic field, and the various equipment and material control requirements. Specific procedures to accomplish process control of Magnetic Particle systems is published in TO 33B-1-2, WP 103 00.

3.6.2 General.

3.6.2.1 Need for Process Control. The presence of magnetic particle indications confirms the existence of discontinuities in the part. However, the absence of indications does not guarantee the absence of discontinuities. Flaws can be present and not be indicated for a number of reasons. Process controls exist to verify the performance of equipment, materials and the inspector. Inspector errors and poorly written procedures are the most common process deficiencies. Any of these deficiencies may occur without being evident during inspection of a part. It is necessary, therefore, to periodically examine the materials, equipment, and process parameters to be sure they are as required for adequate inspection results.

3.6.2.2 New Materials. Magnetic particle materials are subjected to testing during their formulation to ensure their proper composition. However, it is possible to receive materials which do not perform satisfactorily. If unsatisfactory material performance is not discovered until a number of parts have been processed, then extra time and expense is required to track down and reinspect each of the suspect parts, if it is not too late. Unsatisfactory materials can result from a number of causes. The cost of verifying adequate material performance is extremely low and the required tests can be performed at any field laboratory.

3.6.2.3 In-Use Materials. Some inspection processes use the magnetic particle materials only once. In these processes, spraying or dusting is usually the means used to apply the materials. The materials are stored in closed containers until they are used. These processes minimize the possibility of material contamination or degradation during use. More often, however, the materials are used in open tanks where the excess materials are allowed to drain from the part back into the tank. This method provides numerous opportunities for contamination, deterioration, and changes in concentration. Such materials SHALL be checked periodically to be sure they are functioning satisfactorily.

3.6.3 Causes of System Degradation.

3.6.3.1 Contamination. Contamination is a primary source of magnetic particle bath performance degradation. There are a number of contaminants, and their effects on performance can vary. Some of the common contaminants frequently encountered are:

3.6.3.1.1 Water is a common contaminant in petroleum-based baths. It may occur due to condensation, leaks, dripping overhead pipes, or moisture carryover on parts.

3.6.3.1.2 Organics such as paint, lubricants, oils, greases, and sealants are other sources of contamination. These materials are usually introduced into the magnetic particle bath on the parts being inspected, and can react with, or dilute a bath so it loses some or all of its ability to function.

3.6.3.1.3 Organic solvents such as degreaser fluid, cleaning solvent, gasoline, and antifreeze solution, are also potential contaminants. These materials can mix with the inspection bath or float on top of it reducing the bath's effectiveness.

3.6.3.1.4 Dirt, soil, and other insoluble solids can be carried into the magnetic particle bath as a result of inadequate pre-cleaning.

3.6.3.1.5 Acidic and alkaline solutions can contaminate the magnetic particle baths. Acidic and alkaline solutions can be residues of previous plating, paint stripping, and cleaning processes.

3.6.3.2 Evaporation Losses. Magnetic particle bath suspension/vehicle materials used in open tanks are continuously undergoing evaporation, resulting in an increase in particle concentration. The rate of evaporation increases with warmer temperatures and larger tank surfaces. Evaporation losses take place very gradually, so performance change may become significant before it is noticed.

3.6.3.3 Drag-Out. Particle concentration is reduced when particles adhere to parts being inspected and are not returned to the suspension. Like evaporation, the resulting change occurs slowly and would probably go unnoticed until significant performance loss is experienced.

3.6.3.4 Heat Degradation. Fluorescent dyes are sensitive to elevated temperatures. Temperatures of over 140° F (60° C) may reduce the fluorescence, and temperatures over 250° F (121° C), may destroy it completely. High temperatures in magnetic particle inspection materials usually occur when materials are improperly stored. For instances, a dark colored container stored in direct sunlight can reach temperatures above 140° F (60° C).

NOTE

Care SHALL be exercised when storing materials containing fluorescent dyestuffs. They SHALL be stored out of direct sunlight, in a cool dry location (40-80° F) (4-27° C).

3.6.3.5 Equipment Degradation. Similar to materials degradation, the performance of the equipment can also decline due to frequent use. The magnetizing equipment can lose power, while UV-A bulbs and LEDs age and become dirty.

3.6.3.6 Process Degradation. Critical procedural steps may be performed incorrectly or omitted completely. Periodic checks SHALL be accomplished to ensure satisfactory performance.

3.6.4 Frequency of Process Control. One of the factors influencing the degradation of a magnetic particle system (i.e., materials, equipment, and procedures) is the volume of parts being processed. Bath and equipment deficiencies can be expected to occur more often with increased workload volume. Since there is no uniformity in workload between activities, a single calendar schedule cannot be established. Each inspection activity SHALL set inspection intervals based on their workloads. Maximum inspection intervals are listed in TO 33B-1-2 WP 103 00 and SHALL be documented as shown in [Paragraph 1.5.5](#). (Navy activities MAY use a locally produced form.)

3.6.5 Evaluating the Magnetic Particle Process. It may be easier to complete these process control checks if we break them down into categories of equipment evaluations (meaning all equipment and area checks) and materials evaluation (meaning the suspension vehicle and all associated parts). Though some of these tests intertwine, we will first look at the equipment and then move on to the materials.

3.6.6 Evaluating Equipment Effectiveness.

3.6.6.1 General. Magnetic particle equipment SHALL be maintained according to applicable technical orders, commercial manuals, or Navy Maintenance Requirements Cards (MRCs). Specific procedures on how to perform all required checks are published in TO 33B-1-2 WP 103 00.

3.6.6.2 Equipment Tests. Intervals for process control checks are established in TO 33B-1-2 WP 103 00. There are various equipment tests designed to ensure MPI process meets acceptable operating standards. The minimum equipment tests which SHALL be accomplished to ensure the magnetic particle inspection process meets acceptable operating standards are as follows:

- System Effectiveness Check.
- Amperage Indicator Check.
- Quick Break Test.
- Dead Weight Check.
- Field Indicator Check.
- Lighting Checks.
- Inspection Area Cleanliness.

3.6.6.3 Evaluating Applied Magnetic Field Effectiveness.

3.6.6.3.1 Quantitative Quality Indicators (QQI). QQIs ([Paragraph 3.4.5.2.1](#)) also called shims are used to evaluate the applied magnetic field and to perform system effectiveness checks. They are also a very useful tool for technique development.

NOTE

The QQI was designed to be used with the continuous method and the indications may disappear when the applied field is removed. Also, the QQI will not indicate background. The actual part SHALL be examined to determine the amount of background present.

3.6.6.3.2 Using the QQI.

WARNING

Cleaning solvent, A-A-59281, is flammable that also is harmful to the skin, eyes, and respiratory tract. To prevent injury, rubber gloves and goggles SHALL be used. Use in a well-ventilated area.

CAUTION

Exercise care when using QQIs on curved surfaces. Excessive bending will damage a QQI beyond use. Usually the thinner QQI will be used on curved surfaces; however they are fragile. The thicker QQI is less fragile, but can still be damaged by excessive bending.

NOTE

If the QQI is placed in an area where an actual crack may be present then a second magnetic particle or magnetic rubber inspection SHALL be performed without the use of QQIs.

The area where the QQI is to be placed SHALL be thoroughly cleaned and dried. Use cleaning solvent, A-A-59281. Place the appropriate QQI in place with the slot side against the surface of the part. In general, the 30-percent deep slot is adequate for most defects. Critical inspections may require the 15-percent deep slot and rough castings or weldments may require the 60- percent deep slot.

3.6.6.4 System Effectiveness Check.

3.6.6.4.1 Ketos/AS5282 Ring. The Ketos/AS5282 ring can be used to evaluate system effectiveness. While it is a useful tool, it has definite limitations and should not be the only system effectiveness method used. (e.g., Shortcomings include its limitation to central bar conductor DC and/or 3-phase AC units only.) There are two types of rings: Ketos and AS5282 certified rings. The AS5282 rings are certified by the manufacturer as conforming to SAE specification AS5282 and responds with more indications at given amperages than the traditional Ketos ring. Using Ketos ring amperages and requirements on an AS5282 ring may result in false system performance readings. Technicians must know what type of ring they have and work accordingly. AS5282 rings come from the manufacturer with a certificate, the manufacturer's name, serial number and "AS5282" marked directly on the ring. All in-use rings SHALL be traceable to the applicable commercial specification for manufacturing (i.e., Ketos-ASTM E1444, AS5282-SAE AS5282). Even under optimum system conditions, there are cases where Ketos and AS5282 rings do not respond with the specified numbers of indications. Rings SHALL be baseline tested and the indications observed during baseline testing SHALL be documented and appear each time the system effectiveness test is conducted.

NOTE

- Ketos/AS5282 rings that are plated or corroded SHALL NOT be used. Corrosion and plating can cause false readings (superficial cleaning of mild surface corrosion with scotchbrite pad manually is authorized).
- The manufacturer provided certificate of conformance to ASTM E1444 for Ketos Rings SHALL be maintained. (Not Applicable to AS5282 Certified Rings with "AS5282" marked directly on the ring)

3.6.6.4.2 Quantitative Quality Indicators (QQI). Test specimen(s) used with QQIs offer a versatile means of checking system performance in addition to the Ketos/AS5282 ring. The specimens can be real parts or designed to be representative of the most challenging inspection currently being performed. This combination is capable of providing an adequate check on any magnetic particle inspection system. Poor indications may require further process control evaluations to be performed (e.g., amp indicator check, concentration check, etc.). Even though QQIs respond to the applied magnetized force, not residual field, demagnetization is necessary of the specimen(s) in order to remove the previously applied inspection media.

3.6.6.4.3 Cracked Parts.

NOTE

(Air Force Only) The Ketos/AS5282 rings SHALL be the only tools approved to evaluate system effectiveness. Other devices such as cracked parts and QQIs may be used in addition to the Ketos/AS5282 ring to check system effectiveness

When available, cracked parts containing defects that are representative of the flaws that need to be detected may be used in addition to the Ketos/AS5282 ring to check system effectiveness. These reference parts must be examined in accordance with a written procedure and require careful handling to remain corrosion-free and retain their flaw size.

3.6.6.5 Amperage Indicator Check.

NOTE

The amperage indicator accuracy check SHALL be performed using a calibrated ammeter/shunt capable of reading up to 10,000 amps in AC, HWDC and FWDC. The ammeter/shunt SHALL be calibrated as prescribed in TO 33K-1-100-CD-1. (Navy:) Amperage indicator accuracy check SHALL be performed using a calibrated shunt meter, P/N 10090 or equivalent. The shunt meter SHALL be calibrated as prescribed in the naval maintenance procedures.

3.6.6.6 Quick Break Test. A test SHALL be accomplished to ensure the presence of an accurate decay rate, which is sufficient for quick break magnetization. A quick break tester is authorized in AS-455 Operation for the quick break tester SHALL be accomplished according to the commercial manufacturer's operating instructions or TO 33B-1-2, WP103 00 if commercial manual is unavailable. Test failure SHALL necessitate locating the source of the failure and taking corrective action. (Navy:) A test SHALL be accomplished to ensure the presence of an accurate decay rate, which is sufficient for quick break magnetization. A quick break tester, P/N QBT-A or equivalent, shall be used for testing. Operation for the quick break tester SHALL be accomplished according to the commercial manufacturer's operating instructions. Test failure SHALL necessitate locating the source of the failure and taking corrective action.

3.6.6.7 Dead Weight Check. This test SHALL be conducted on portable induced field equipment (e.g., Parker Probes, magnetic yokes) IAW TO 33B-1-2 WP 103 00.

3.6.6.8 Lighting Checks. For additional information on UV-A and ambient light checks (see [Paragraph 2.5.4.1.3](#)).

3.6.6.8.1 Black Lights.

- a. Check the intensity of new UV-A bulbs and LEDs.
- b. Check the intensity of in-use UV-A bulbs and LEDs.
- c. Check the physical condition of the housing and filter. Housings and filters SHALL be kept clean, free of cracks or chips, and fit properly.

3.6.6.8.2 Ambient Light Requirements. Inspection booths of a stationary fluorescent magnetic particle system SHALL NOT exceed 2 foot-candles of ambient light. During portable inspections ambient light should be reduced as much as practical. However, it is not always possible to achieve ambient light levels as low as 2 foot-candles. When 2 foot-candles cannot be attained, increasing the UV-A intensity can partially compensate.

3.6.6.8.2.1 Measurement of Visible Light Intensity. Visible light intensity is easily measured with solid-state photometers. Measurements of visible light are keyed to the response of the visual system of a standard human observer. The unit of measure for visible light is the lumen. The lumen represents the amount of energy in the visible light spectrum specifically distributed to the response of the average human eye. Therefore, the lumen is actually the energy flux (energy per unit of time). The units of measurement for visible light intensity are foot-candles, where one foot-candle equals one lumen per-square-foot. Another term often used is lux, which equals one lumen per-square-meter. The conversion between the two terms is 1- foot candle equals 10.76 lux.

3.6.6.8.2.2 Excessive White Light. Cumulative ambient light from the fully darkened booth, including white light emitted by the UV-A lamps SHALL not exceed 2 foot-candles.

3.6.6.8.3 Dark Adaptation. The human eye becomes much more sensitive to light under dark conditions. This increased sensitivity gradually occurs when the light conditions change from light to dark. When entering a darkened area from a lighted area, the pupil of the eye must widen to admit additional light. The time required for the eye to adjust to the darkened condition depends upon the overall health and age of the individual. Full sensitivity or dark adaptation requires about 20- minutes. A minimum dark adaptation time of 1 minute is sufficient to perform magnetic particle inspection under UV-A. Thus, an inspector entering a darkened area SHALL allow 1 minute for dark adaptation before examining parts under UV-A illumination . Once the eyes have adapted to the dark, the pupils will respond very rapidly to bright light. A very short bright light exposure cancels the slowly acquired dark adaptation. Time for dark adaptation SHALL be allowed whenever an inspector enters the darkened booth, or is exposed to a bright light (e.g., someone opening or raising the shade). A timer capable of measuring the dark adaptation time SHALL be available within the darkened area.

3.6.6.9 Inspection Area Cleanliness. The inspection area, as well as, the hands and clothing of the inspector, SHOULD be clean and free of extraneous fluorescent materials. Non-relevant indications may be formed when parts contact extraneous fluorescent materials. In addition, the fluorescence from this material will raise the ambient light level, thus increasing the amount of UV-A necessary to produce a visible indication of a small defect.

3.6.7 Evaluating Material Effectiveness.

3.6.7.1 General. Magnetic particle materials SHALL be maintained according to applicable technical orders, commercial manuals, or Navy Maintenance Requirements Cards (MRCs).

3.6.7.2 Applicability. Material tests apply to both newly received and in-use materials. They are designed to ensure unsatisfactory materials do not enter the magnetic particle inspection process, and in-use materials continue to perform satisfactorily.

NOTE

Prior to bath replacement in a magnetic particle inspection unit, the equipment SHALL be thoroughly cleaned according to the equipment maintenance manual. This does not apply to the addition of materials (either vehicle or particles) to maintain concentration.

3.6.7.3 Material Tests. Frequencies of all process checks are established in TO 33B-1-2 WP 103 00. The following lists the minimum material tests which SHALL be accomplished to ensure the magnetic particle inspection process meets acceptable operating standards:

- Concentration Check.
- Settling Check.
 - Concentration Check.
 - Background Fluorescence.
 - Contamination.
- Acidity Test.
- Water Break Test.

3.6.7.3.1 New Material Tests. New materials SHALL be subjected to the following tests, as appropriate, prior to being put into use:

- a. Perform a contamination and a background fluorescence check on petroleum based bulk vehicle.
- b. Use the settling test to check the concentration level, background fluorescence, and for any contamination of the newly mixed bath.
- c. Perform a system effectiveness test on both conventional magnetic particle inspection materials and magnetic rubber inspection materials (if used).

3.6.7.3.2 In-Use Material Tests. In-use materials SHALL be tested in accordance with the frequency established in TO 33B-1-2 WP 103 00.

3.6.7.4 Preparation of New Wet Suspension.

3.6.7.4.1 Tank Inspection and Cleaning. When new equipment is being installed, or after emptying dirty suspension from the in-use tank, the agitation/circulation system SHALL be inspected and cleaned as necessary to ensure it is not contaminated with particles or dirt.

3.6.7.4.2 Preparation of New Bulk Suspension Materials. Fluorescent materials also require an additional fluorescent background check (see TO 33B-1-2 WP 103 00). Fill the tank with oil or water, depending on which is chosen as the vehicle, and operate the agitation system to ensure it is functioning properly. If petroleum based, bulk vehicle is used, the following check SHALL be performed prior to formulating the inspection bath. This will prevent unsatisfactory bulk magnetic particle vehicle from being introduced into the magnetic particle inspection system.

- a. Loosen the cap on the bulk vehicle container, and leave the container undisturbed for at least 1-hour.
- b. After the time has elapsed, without disturbing the container, remove the cap, cover, seal, or plug from the bulk vehicle container.
- c. Obtain a clean glass tube of sufficient length so it reaches from the bottom of the bulk vehicle container to at least 6-inches above the container opening when the tube is held in the vertical position.

- d. Place your thumb over one end of the glass tube, and insert the other end of the glass tube slowly, in a vertical position, into the bulk vehicle.

NOTE

Ensure the tube goes all the way to the bottom of the container.

- e. Release your thumb from the upper end of the glass tube for 5 to 10-seconds, and then replace your thumb over the end of the glass tube. Maintain its vertical position and remove the glass tube slowly from the bulk vehicle.
- f. Prior to removing your thumb from the end of the glass tube, observe the level of the contamination in the glass tube. If present, water and other contaminants should be evident in the lower portion of the glass tube. (Depots: if the vehicle is suspected, the contents of the glass tube may be sent to the depot chemical laboratory for analysis).
- g. If contaminants are evident in the bottom of the container, siphon off the good vehicle to within 2-inches of contamination level.
- h. Disposition instructions for contaminated bulk vehicle are located in [Paragraph 3.6.9](#).

3.6.7.4.3 Particle Concentration Test.

NOTE

Prior to adding the magnetic particles to the vehicle, they SHALL be demagnetized to eliminate any agglomeration that may have developed during storage due to magnetization.

The concentrates to be added to the bath, and the volume of solid materials which settle out when the bath is made up, should conform to the manufacturer's data supplied with the concentrate. Concentrate SHALL be added when the particle concentration is low. Evaporation or liquid drag-out SHALL be monitored and volume maintained when the level drops appreciably. Loss of liquid may be by either drag-out or by evaporation, and corrective measures are different for both types of loss. Adding additional oil or water is all that is required to make up for evaporation loss. To make up for the drag-out loss, the addition of bath liquid and particles may be required.

3.6.7.4.3.1 The strength of the bath is a major factor in determining the quality of the indications to be obtained. Too heavy of a concentration will give a confusing background with excessive adherence of particles at external poles. This will reduce the visibility of indications from very fine discontinuities.

3.6.7.4.3.2 It is difficult to know what the cause of volume loss is in any given case. For a unit used only occasionally, loss by evaporation is likely to be the major cause. For a unit in constant use, it can be assumed that more than 50-percent of the loss is due to drag-out. This problem is not serious, because with constant use, the accumulation of dirt, scraps, lint, etc. requires the disposing of the in-use bath and a new bath is typically prepared before loss of liquid becomes serious. Magnetic particle content is of most critical importance and SHALL be carefully watched at all times.

3.6.7.4.3.3 Dirt accumulation in the magnetic particle bath can usually be observed in the settling test. Dirt, lint, etc. are usually lighter and settle later. Dirt, lint, etc. are often seen as a second layer on top of the particles, or as a non-fluorescent band or strip in the particle layer. The layer of dirt and the vehicle immediately above it SHALL NOT fluoresce. For particle concentration determination, this layer of dirt SHALL be carefully excluded from the total volume read. Formation of proper indications will be impeded when the contamination exceeds 30-percent of the volume of the particle layer. At that point, the bath SHALL be properly disposed of and new bath placed into service. This may occur as often as once a week when a unit is in constant use. If oil is used as a suspension, the disposition of the bath SHALL conform to all applicable regulations for petroleum products.

3.6.7.4.3.4 The following ranges are rather broad for uniform results and are provided for maintaining magnetic particles suspension concentration. These ranges should be reduced by each laboratory depending on their specific requirements.

- Visible magnetic particle bath concentrations SHALL be 1.2 to 2.4-milliliters (ml) of particles per 100 ml of vehicle. The optimum range is 1.5 to 2.0 ml/100 ml.

- Fluorescent magnetic particle bath concentrations SHALL be 0.1 to 0.4-ml of particles per 100 ml of vehicle. The optimum range is 0.15 to 0.20 ml/100 ml.

3.6.7.4.4 Adding Dry Powder Concentrate. Measure out the required amount of powdered concentrate, and pour it directly into the bath within the tank. The agitation system should be running and the concentrate poured in at the pump intake. Therefore, it will be quickly drawn into the pump and dispersed into the bath. The new pre-wet concentrates will disperse very quickly even through the large volume of bath in large units. After 10-minutes of operation, the bath strength SHOULD be checked with a settling test.

3.6.7.4.5 Adding Paste Concentrate. This procedure is similar to the dry powder concentrates, except the paste SHALL be weighed instead of measured. The paste is transferred to a mixing cup or bowl, bath liquid is added a little at a time, and mixed until smooth, thin, slurry has been produced. This slurry is then poured into the tank at the pump intake and dispersed into the bath. After agitating 10 minutes, the strength SHOULD be checked by the settling test as in the case of the dry powder concentrate.

3.6.7.5 Evaluating In-Use Wet Suspensions.

3.6.7.5.1 Suspension Maintenance. As the suspension bath is used for testing, it will undergo changes. Some of these changes are:

- Drag-out of magnetic particles by mechanical and magnetic adherence to parts.
- Drag-out of liquid due to the film that adheres to the surface of parts.
- Loss of liquid by evaporation.
- A gradual accumulation of contaminants: shop dust, dirt from parts improperly cleaned, lint from wiping rags, and oil from parts that carry a residual film of oil.
- Miscellaneous objects and materials which are dropped into the tanks.
- Dilution/contamination of the bath from wet test pieces, dripping overhead pipes, and moisture condensation.

3.6.7.5.2 Suspension Agitation. Magnetic particles are considerably heavier than the vehicle in which they are suspended. When the agitation system is shut off, the particles rapidly settle out. All particles SHALL be agitated into suspension before conducting any inspections or process control tests. The agitation time varies with downtime due to the compacting of the particles from their own weight.

3.6.7.5.3 Settling Test. Procedures for performing the settling test are listed in TO 33B-1-2 WP 103 00.

3.6.7.5.3.1 Additional Settling Test Requirements for Wet Fluorescent Suspension. There are three additional sources of deterioration that can occur in a bath of fluorescent particles. When the condition becomes excessive, dispose of the bath.

3.6.7.5.3.1.1 The first source of deterioration is the separation of the fluorescent pigment from the magnetic particles. Such separation causes a reduction of fluorescent brightness of indications and an increase in the overall fluorescence of the background. When this occurs to a noticeable degree, the bath SHALL be changed. This condition is difficult to detect in the settling test, but can be observed by directing a UV-A lamp at the settling tube after the normal settling period. Noticeable fluorescence of the solution, with a reduced fluorescence of the particles, signifies separation. Observation by the inspector in the way the bath performs is another method of detecting separation.

3.6.7.5.3.1.2 A second source of deterioration of the bath of fluorescent particles is the accumulation of non-fluorescent magnetic dust or dirt in the bath. When there is a considerable amount of finely divided magnetic material in the dust carried by the air, this material will accumulate in the bath along with other dust and dirt. In a bath of wet visible non-fluorescent particles this does no specific harm until the accumulation of total dirt is excessive. In the case of fluorescent particles, it tends to decrease the brightness of the indication. The fine magnetic material is attracted to indications along with the fluorescent particles, and it takes very little of such non-fluorescent material to significantly reduce the brightness or visibility of the indication.

3.6.7.5.3.1.3 A third source of deterioration of the fluorescent particle bath is the accumulation of fluorescent oils and greases from the surfaces of tested parts. Over time, this accumulation, builds up the fluorescence of the liquid vehicle to the point that it interferes with the visibility of fluorescent particle indications.

3.6.8 Additional Tests for Water Baths.

3.6.8.1 Wetting Agents and Corrosion Inhibitors. Usually magnetic particle concentrates provide the correct amount of wetting agent and corrosion inhibitor for initial use. However, these materials are also available separately so the concentrations can be maintained or adjusted to suit the particular conditions. If no corrosion can be tolerated, a higher concentration of corrosion inhibitor will be used.

3.6.9 Disposition for Nonconformance Materials.

NOTE

Knowledge of problems, even relatively minor ones, is essential for improvement in the NDI program. Information copies of written correspondence concerning unsatisfactory magnetic particle inspection materials SHALL be furnished to: (Air Force NDI Office, AFLCMC/EZPT-NDIO, aflcmc-ezpt-ndio@us.af.mil, DSN 339-4931, DSN 339-4931 and AFRL/RXSA, 2179 Twelfth Street, Ste. R43, Wright-Patterson Air Force Base, OH 45433-7718); (Army: AMCOM Corrosion Protection Office - NDT, RDMR-WDP-A, Bldg. 7631, Redstone Arsenal, AL 35898; DSN 897-0211.). All materials which DO NOT meet the minimum requirements SHALL be rejected. Rejected materials SHALL be reported in accordance with TO 00-35D-54. (Navy: SHALL refer to OPNAV 4790.2 Quality Deficiency Reporting QDR requirements.)

3.6.9.1 Open tank baths SHALL be changed (replaced or replenished) when they do not meet the minimum inspection requirements.

SECTION VII MAGNETIC PARTICLE INSPECTION EQUATIONS

3.7 MAGNETIC PARTICLE EQUATIONS.

3.7.1 Rule-of-Thumb Formulas. Rule of thumb guidance for circular magnetization can be found in [Paragraph 3.4.4.5.3](#). Rule-of-thumb formulas have been developed to help determine the amount of amperage required to induce an adequate longitudinal magnetic field in a part. These formulas apply particularly well to cylindrically shaped parts and are explained with examples shown in the following paragraphs. However, as discussed previously, blind adherence to these "rules of thumb" can result in over magnetization with a subsequent loss of inspection sensitivity.

3.7.2 Cross-Sectional Area. It is critical to determine the relationship between the cross-sectional area of the part and the cross-sectional area of the coil(s). This relationship/ratio will determine whether the part can be inspected within a coil of a given diameter by laying the part in the bottom or next to the side of the coil wall, or by centering the part in the coil, and which formula will be used for estimating the amperage required. The cross-sectional area for the part and coil are determined as follows:

$$A = \Pi r^2$$

Where: A = Cross-sectional Area

$$\Pi = 3.1416$$

r = radius (1/2 of the diameter). The diameter of the part SHALL be taken as the largest distance between any two points on the outside circumference of the part.

Example: A 12-inch diameter coil is to be used to inspect a part having a 2-inch diameter.

Area of Coil (12" diameter)

$$A = \Pi r^2$$

$$A = \Pi(6)^2$$

$$A = 113 \text{ sq. inches}$$

Area of Part (2" diameter)

$$A = \Pi r^2$$

$$A = \Pi(1)^2$$

$$A = 3.14 \text{ sq. inches}$$

3.7.2.1 When the cross-sectional area of the part is less than one-tenth of the cross-sectional area of the coil, the part SHOULD be magnetized lying in the bottom of the coil.

3.7.2.2 When the cross-sectional area of the part is greater than one-tenth of the cross-sectional area of the coil, the part must be magnetized in the center of the coil.

3.7.2.3 When using a cable wrap or when the cross-sectional area of the part exceeds one-half of the cross-sectional area of the coil, the part SHOULD be centered in the coil and the formula for high fill factor coils SHALL be used for estimating the required amperage.

3.7.2.4 The diameter of the largest part that can be magnetized lying in the bottom of a coil or placed next to the coil wall for some typical coil sizes is listed in [Table 3-8](#). For any given coil diameter, parts with diameters larger than those listed SHALL be magnetized by some other method, such as centering them in the coil, using a cable wrap, or using a larger coil.

Table 3-8. Coil Size Vs. Maximum Diameter for Parts Magnetized in Bottom of Coil

Coil Diameter (inches)	Maximum Part Diameter (inches)
8	2.5
12	3.8
15	4.8
16	5.0
18	5.7
20	6.3
24	7.6

3.7.3 Calculating Coil Current. Two rule-of-thumb formulas have been developed for use in estimating the coil current levels to be used for longitudinal magnetization. One formula is for a part centered in the coil and the other for a part lying in the bottom of the coil. These formulas apply to cylindrical and irregularly shaped parts and at one time were thought to estimate the required current to within 10-percent. Recent studies show in almost all instances they overestimate the required current by at least 50-percent. They use the part length-to-diameter (L/D) ratio. The useful magnetizing field produced by an encircling coil extends approximately 6 to 9-inches to either side of the coil. For parts longer than the effective field distance, one or more inspections are required along the length of the part. When repositioning these longer parts in the coil, allow a 3- inch effective field overlap. The formulas are intended for part with a L/D ratio between 2, and 15. To inspect parts with an L/D ratio of 2 or less, ([Paragraph 3.7.3.6](#)). For parts with an L/D ratio greater than 15, use 15 as the value for the ratio.

3.7.3.1 Formula for Part Lying in Bottom of Coil. The following formula can be used when the cross-sectional area of the part is less than one-tenth the cross-sectional area of the coil(s) and SHALL be used whenever the part is lying in the bottom of the coil, or is placed next to the coil wall during magnetization. If the part has hollow portions, replace D with D_{eff} ([Paragraph 3.7.3.4](#)).

$$I = \frac{KD}{NL}$$

Where:

I = Current through coil (amperes)

K = 45,000 (a constant, ampere-turns)

L = Length of the part (inches)

D = Diameter of the part (inches)

N = Number of turns in coil

Example: Determine the current required to longitudinally magnetize a steel part, 10-inches long with a diameter of 2-inches using a 12-inch diameter coil having 5 turns. To determine cross-sectional area ratio between part and coil, refer to [Paragraph 3.7.2](#). Substituting the known values and doing the calculations gives:

$$I = \frac{45000 \times 2}{5 \times 10}$$

$$I = 1800 \text{ amperes}$$

Typical currents for a five turn coil with the parts lying in the bottom of the coil or held next to the coil wall are provided in [Table 3-9](#).

Table 3-9. Typical Coil-Shot Current for a Five-Turn Coil With Part in Bottom of Coil

Part Length in Inches (L)	Part Diameter in Inches (D)	L/D Ratio	Ampere-Turns Required	Amperes Required
12	3	4	11,250	2,250
12	2	6	7,500	1,500
16	2	8	5,625	1,125
10	1	10	4,500	900
18	1 1/2	12	3,750	750
14	1	14	3,214	643

3.7.3.2 Formula for Part in Center of Coil. This formula SHALL be used when the cross-sectional area of part is greater than one-tenth and less than one-half of the cross-sectional area of the coil(s).

$$I = \frac{KR}{N(6(L/D) - 5)}$$

Where:

I = Current through coil (amperes) [\(Paragraph 3.7.3.1\)](#)

K = 43,000 (a constant, ampere-turns) [\(Paragraph 3.7.3.1\)](#)

R = Radius of coil (inches)

N = Number of turns in coil [\(Paragraph 3.7.3.1\)](#)

L = Length of part (inches)

D = Diameter of the part (inches) [\(Paragraph 3.7.3.1\)](#)

The term 6(L/D)-5 is called the effective permeability.

Example: Determine the current needed to longitudinally magnetize a 12-inch long part with a diameter of 4-inches and using a 5 turn, 12-inch diameter coil. To determine the cross-sectional area ratio between the part and the coil, refer to [Paragraph 3.7.2](#). If the part contains hollow portions, D should be replaced with D_{eff} [\(Paragraph 3.7.3.4\)](#).

Substituting known values gives:

$$I = \frac{43000 \times 6}{5(6(12/4) - 5)}$$

$$I = 3969 \text{ amperes}$$

3.7.3.3 Formula for Cable Wrap or High Fill-Factor Coils. When using a cable wrap or when the cross-sectional area of the part is greater than one-half of the cross-sectional area of the coil, the following formula SHALL be used for estimating the current required to longitudinally magnetize a part centered in the coil. If the part has hollow portions, replace D with D_{eff} in the formula [\(Paragraph 3.7.3.4\)](#).

$$I = \frac{K}{N((L / D) + 2)}$$

Where:

- I = Current through coil (amperes) [\(Paragraph 3.7.3.1\)](#)
- K = 35,000 (a constant, ampere-turns) [\(Paragraph 3.7.3.1\)](#)
- N = Number of turns in coil [\(Paragraph 3.7.3.1\)](#)
- L = Length of part (inches)
- D = Diameter of the part (inches) [\(Paragraph 3.7.3.1\)](#)

Example: Determine the required current to longitudinally magnetize a part, 12-inches long with a 4 inch diameter using the cable wrap technique with a 3 turn wrap.

Substituting known values gives:

$$I = \frac{35000}{3((12/4) + 2)} \qquad I = 35000/3(12/4 + 2)$$

$$I = 2333 \text{ amperes}$$

3.7.3.4 Formula for Hollow Parts or Parts Having Hollow Portions. If a part has hollow portions, replace the diameter (D) with the effective diameter (D_{eff}), which is calculated using:

3.7.3.4.1 Determining the Effective Diameter. For hollow and cylindrical test parts, the diameter of the test part is substituted with the calculated effective diameter. Calculate the effective diameter as follows:

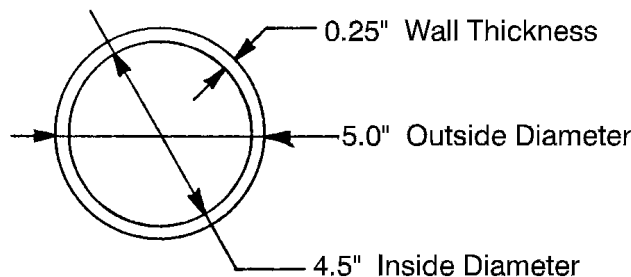
$$D_{eff} = \sqrt{(OD)^2 - (ID)^2}$$

3.7.3.4.1.1 Example: Determine the effective diameter of a tube-shaped part with an outside diameter equal to 5-inches and an inside diameter of 4.5-inches.

$$= \sqrt{(25 - 20.25)}$$

$$= \sqrt{4.75}$$

$$D_{eff} = 2.179$$



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Figure 3-72. Calculating Effective Diameter

3.7.3.4.1.2 To calculate the current required to longitudinally magnetize the part in the above example, use the formula from [Paragraph 3.7.3.1](#) for the part in the bottom of a 12-inch diameter coil with 5 turns, except replace D with D_{eff} (2.179):

$$I = \frac{KD}{NL}$$

$$I = \frac{45000 \times 2.179}{5 \times 10}$$

$$I = 1961 \text{ amperes}$$

3.7.3.5 In the examples of [Paragraph 3.7.3.1](#) and [Paragraph 3.7.3.4](#) above, the differences in the current required to longitudinally magnetize the solid and hollow parts are compared in [Table 3-10](#). The only difference in the two parts is one was hollow and the other was solid. If the effective diameter D_{eff} had not been considered, the current for the hollow part would have been over estimated by 927 amperes. This additional amperage would certainly result in excessive background and possibly false indications from over-magnetizing the part.

Table 3-10. Comparison of Coil Amperages for Solid vs. Hollow Parts

	Solid Part	Hollow Part
Part Length	10 inches	10 inches
Part Diameter	2 inches	2 inches
Coil Description	5-turn, 12-inch diameter	5-turn, 12-inch diameter
Amps Required	1800	873

3.7.3.6 If the need arises to inspect parts having L/D ratios of 2 or less, the effective L/D ratio SHALL be increased by placing the part between two pole pieces while it is being magnetized. The length dimension for the L/D ratio then becomes the length of the two pole pieces plus the part length. Such pole pieces must make good contact on each side of the part and must be made of ferromagnetic material. Solid steel pole pieces may be used when direct current is used in the coil and the continuous method of inspection is used. If the continuous method is used with either AC or half-wave DC current in the coil, the pole pieces SHALL be made from laminated magnetic material similar to the silicon steel legs of a hand probe with articulated legs. This is also true for residual inspection. Pole pieces SHALL be made from the ferromagnetic if residual inspection, or the wet continuous method of inspection with AC or half-wave DC, is to be used.

NOTE

Pole piece may be needed on some parts with an L/D ratios greater than 2, especially if the area of interest on part is close to the end.

SECTION VIII MAGNETIC PARTICLE INSPECTION SAFETY

3.8 MAGNETIC PARTICLE SAFETY.

3.8.1 **Safety Requirements.** Safety requirements SHALL be reviewed by the laboratory supervisor on a continuing basis to ensure compliance with provisions contained in AFMAN 91-203 as well as provisions of this technical order and applicable weapons system technical orders. Recommendations of the installation Bioenvironmental Engineer and the manufacturer regarding necessary personnel protective equipment SHALL be followed.

NOTE

AFMAN 91-203 or appropriate service directive SHALL be consulted for additional safety requirements.

3.8.2 General Precautions. Precautions to be exercised when performing magnetic particle inspection include consideration of exposure to oils, pastes, and electrical current. The following minimum safety requirements SHALL be observed when performing magnetic particle inspections.

3.8.3 Floor Matting. Use rubber insulating floor matting in front of magnetic particle units. This matting SHALL be rated for the voltage of the equipment being utilized. This matting SHALL be replaced when it is worn to one-half the original thickness (approximately 1/8-inch). Use only one continuous length of matting and ensure it continues beyond the ends of the equipment for at least 24-inches. If facility construction or safety walkways prevent extension beyond equipment, local safety office may approve deviation IAW 91-203 or other service directive.

3.8.4 Wet Suspension Precautions. Wet magnetic particle materials are normally nontoxic, but continuous exposure to oils and pastes used in the wet bath method may cause dermatitis or cracking of the skin. Protective gloves SHALL be worn during this process.

3.8.4.1 If a magnetic particle suspension oil, with a flash point of less than a 200° F is maintained in a Type II stationary magnetic particle unit, the following minimum safety requirements apply:

- Provide an adequate surface area exhaust ventilation system as determined by the local base bioenvironmental engineer.
- Maintain less than 25 gallons of liquid suspension in the tank.
- Cover the liquid suspension by a screened drain board.
- Provide a portable fire extinguisher, sufficient in size and/or volume to suppress any fire which could occur from the magnetic particle suspension oil. The fire extinguisher size and/or volume SHALL be determined by the local fire chief.

3.8.5 Arcing Precautions. Arcing may be caused by poor contact between the head stocks of the stationary magnetic particle unit. This arcing or excessive magnetizing current may injure the eyes. Arcing may also ignite combustible magnetic particle baths (e.g., oil). Ensure good electrical contact between the heads and the inspected part to prevent this possibility. The head stocks SHALL be wetted with the magnetic particle bath prior to energizing to reduce the possibility of arcing. Even the smallest of arc burns can seriously damage a part if it occurs in a highly stressed location. If written direction on dealing with an arc burn is not available, cognizant engineering should be contacted for disposition.

NOTE

The use of prods is prohibited on aircraft parts. Ensure they are not used in any hazardous area.

3.8.6 Head Stocks. Many units can be hand cranked to hold the part in place between the head stocks, and then air controlled pressure is applied with a foot pedal to ensure a solid fit between the stocks. In order to avoid injuring the inspector's hands, extreme care SHALL be maintained when placing articles between the head stocks of a magnetizing unit.

3.8.7 UV-A Hazards.

WARNING

Unfiltered ultraviolet radiation can be harmful to the eyes and skin. UV-A lamps SHALL NOT be operated without filters. Cracked, chipped, or ill-fitting filters SHALL be replaced before using the lamp

Prolonged direct exposure of hands to the filtered UV-A lamp main beam may be harmful. Suitable gloves SHALL be worn during inspections when exposing hands to the main beam.

3.8.7.1 The temperature of some operating UV-A bulbs reaches 750°F (399°C) or more during operation. This is above the ignition or flash point of fuel vapors. These vapors will burst into flame if they contact the bulb. UV-A lamps SHALL NOT be operated when flammable vapors are present.

3.8.7.1.1 Exercise care when using hot mercury vapor or gas discharge lamps so as not to burn hands, arms, face, or other exposed body areas. Do not lay hot UV-A lamps on combustible surfaces. The bulb temperature also heats the external surfaces of the lamp housing. The temperature is not high enough to be visually apparent, but is high enough to cause severe burns with even momentary contact of exposed body surfaces. Extreme care SHALL be exercised to prevent contacting the housing with any part of the body. Consult your local bioenvironmental office for specific guidance.

3.8.7.1.2 When practical, provide brackets or hangers in the area of UV-A lamps use to permanently lamps at the wash station and within the inspection booth.

3.8.7.1.3 UV-A filtering safety glasses are specifically designed for penetrant and magnetic particle inspections and are recommended as they will filter out glare and reduce eyestrain. Install ultraviolet filters on all mercury vapor lamps used for penetrant inspection. Replace cracked, chipped, or broken filters before using the light. Injury to eyes and skin will occur if the light from the mercury vapor bulbs is not filtered. UV-A filtering safety glasses, goggles, or face shields SHALL be worn and precautions SHALL be taken to cover exposed skin that is exposed to the direct beam of any UV-A. This includes mercury vapor lamps, gas discharged lamps, and LED lights.

3.8.8 Hazards of Aerosol Cans. Aerosol cans are a convenient method of packaging a wide variety of materials. Their wide use, both in industry and the home, has led to complacency and mishandling. Some of the hazards in the use of aerosol cans are discussed below.

3.8.8.1 The containers are gas pressure vessels which when heated to temperatures above 120°F (49°C) increases the gas pressure resulting in possibly bursting the container. Any combustible material, regardless of flash point, can ignite with explosive force when it is finely divided and dispersed in air. Magnetic particle materials SHALL be stored in a cool dry area, protected from direct sunlight.

3.8.9 Magnetic Rubber Precautions. General safety precautions are applicable to magnetic rubber inspection. The silicon rubber, dibutyltin dilaurate, stannous octoate, cure stabilizers, cleaners, and release agents are or can be skin and eye irritants, skin sensitizers (causing allergic reactions), inhalant and ingestion hazards. For specific information concerning any of the materials used as magnetic rubber, magnetic rubber catalysts, release agents, or cleaners consult the Material Safety Data Sheets, or contact the appropriate Safety Officer. Silicon oil is an ingredient in the material and can result in very slippery surfaces, especially floors, if not well controlled. When performing magnetic rubber inspection on aircraft using electromagnets to magnetize, the aircraft SHALL be grounded.

CHAPTER 4 EDDY CURRENT INSPECTION METHOD

SECTION I EDDY CURRENT INSPECTION (ET) METHOD

4.1 GENERAL CAPABILITIES OF ET.

4.1.1 Introduction to Eddy Current Inspection. This method is used to detect discontinuities in parts that are conductors of electricity. An eddy current is a circulating electrical current induced in a conductor by an alternating magnetic field. An eddy current instrument generates an alternating current that is designed to go through a coil of copper wire that has been placed in a holder called a "probe." This results in the coil producing an alternating magnetic field that when placed near a conductor, generates electrical currents within the conductor ([Figure 4-1](#)). When these eddy currents encounter an obstacle such as a crack, the normal path and strength of the currents is changed and this change is detected, processed and then displayed on the instrument display.

4.1.1.1 Eddy Current Inspection is a "reference" type inspection. The term "reference" means a standard is used to setup the equipment. Results are only as good as the reference standard(s) used. For flaw detection, a minimum of three flaws of varying sizes is recommended for setup. The three flaws represent a closer standardization method for inspection reliability and probability of detection (POD) data. Calibration standards are also used for thickness measurements and conductivity testing. The term "calibration" refers to the use of standards directly traceable to a National Institute of Standards and Technology (NIST) standard that is government controlled.

4.1.2 Definition of Eddy Current. Eddy currents are electrical currents induced in a conductor by a time-varying magnetic field. Eddy currents flow in a circular pattern, but their paths are oriented perpendicular to the direction of the magnetic field.

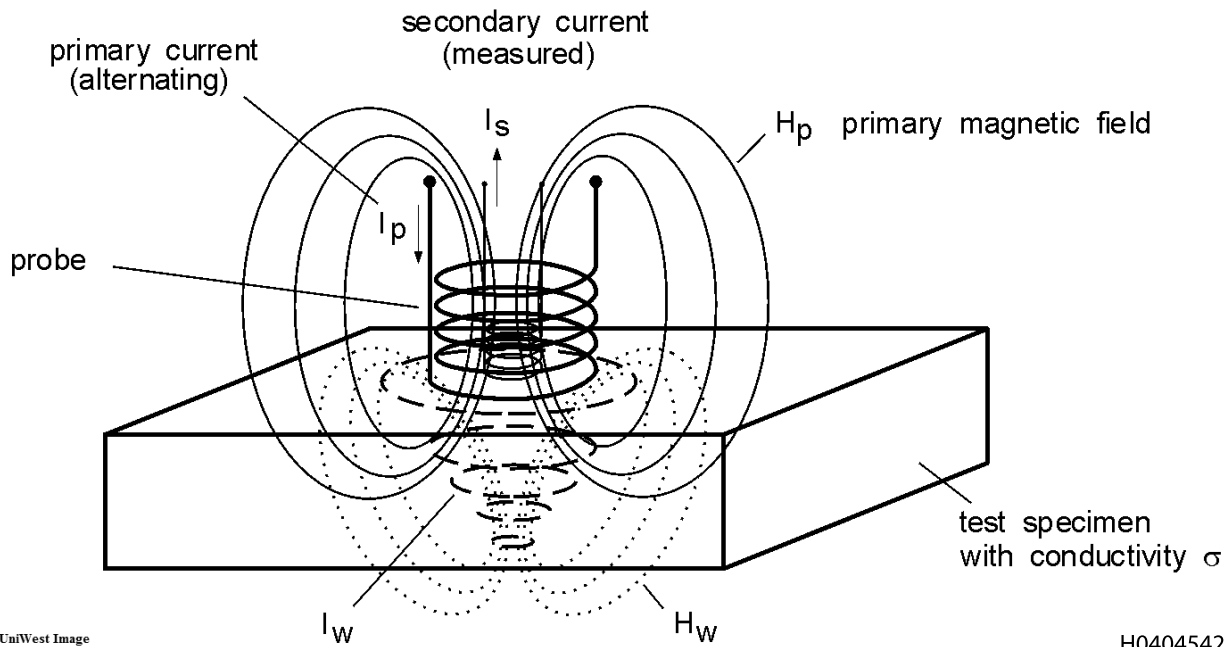
NOTE

When the ferromagnetic properties of the specimen are of interest, magneto inductive testing is the more appropriate term. For the purposes of this chapter, Eddy Current, Eddy Current Inspection, and ET will be used.

4.1.3 Inspection With Eddy Current. The eddy current inspection method is a highly capable, reliable inspection method. When used by a trained technician, it can be used to detect surface and some subsurface cracks, determine material properties, and measure the thickness of thin materials, conductive coatings and non-conductive coatings on conductive substrates.

4.1.4 Advantages of the Eddy Current Method. The following are some advantages of the eddy current method:

- Instantaneous results
- Little part preparation
- No hazardous materials required
- Sensitive to small flaws
- Little to no operator danger



USAF/UniWest Image

H0404542

Figure 4-1. Generation of Eddy Currents

4.1.5 Limitations of the Eddy Current Method. The following are some limitations to the ET method:

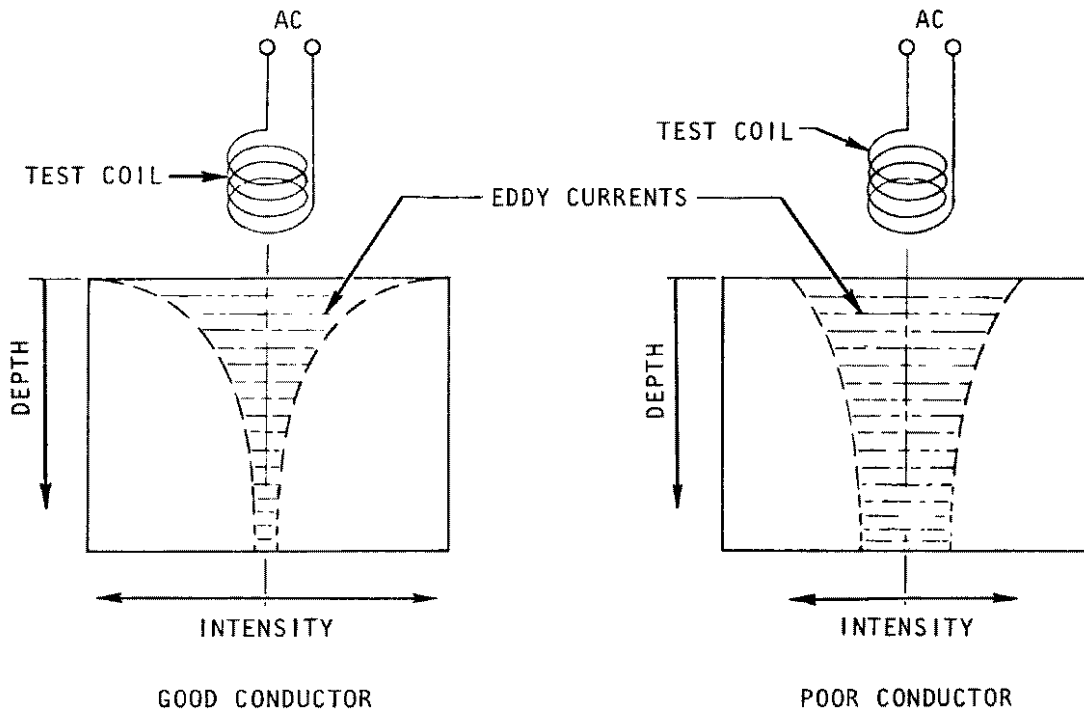
- Inspection is limited to electrically conductive materials
- Flaws that run parallel to the surface are difficult to detect
- Ferromagnetic materials have permeability effects that conflict with conductivity
- Capability is related to the skill of the operator

4.1.6 Variables Affecting Eddy Currents. Inspection parameters such as the coil-to-specimen separation (also called lift-off or fill-factor, depending on the type of coil used) and coil assembly design may cause the eddy currents to vary. A consequence of this is often that eddy current for one condition (e.g. presence of discontinuities), can be hampered by variations in properties not of concern (e.g. specimen geometry). In most cases, the effects of variations in properties not of interest can be minimized or suppressed. The generation and detection of eddy currents in a part are largely dependent on:

- The inspection system
- Material properties of the part
- The test conditions

4.1.6.1 Effect of Conductivity on Eddy Currents. The distribution and intensity of eddy currents in non-ferromagnetic materials is strongly affected by electrical conductivity. In a material of relatively high conductivity, strong eddy currents are generated at the surface. In turn, the strong eddy currents form a strong secondary electromagnetic field opposing the applied primary field. As a result, the strength of the primary field decreases rapidly with increasing depth below the surface. In poorly conductive materials, the primary field generates small amounts of eddy currents, which produce a small opposing secondary field. Therefore, in highly conductive materials, strong eddy currents are formed near the surface, but their strength reduces rapidly with depth. In poorly conductive materials, weaker eddy currents are generated near the surface, but they

penetrate to greater depths. The relative magnitude and distribution of eddy currents in good and poor conductors are shown in [Figure 4-2](#).

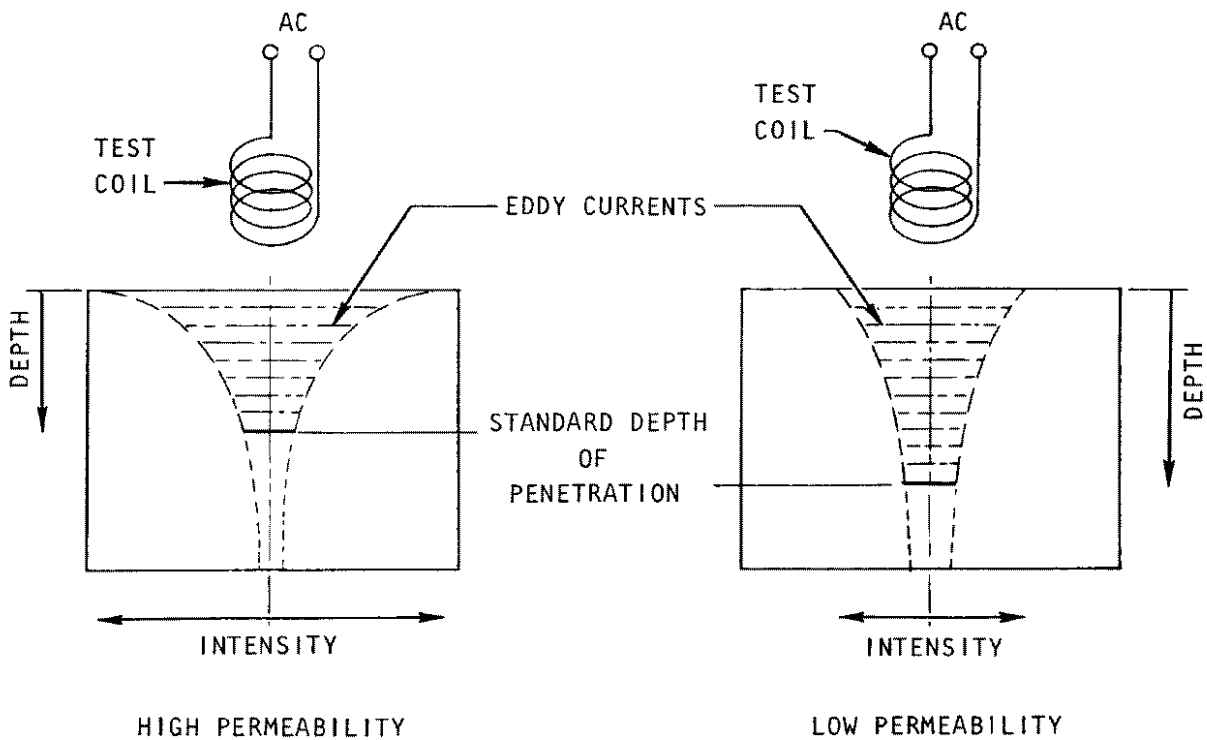


H0404486

Figure 4-2. Relative Magnitude and Distribution of Eddy Currents in Good or Poor Conductors

4.1.6.2 Effect of Permeability on Eddy Currents. Eddy current testing of ferromagnetic parts is usually limited to testing for flaws or other conditions that exist at or very near the surface of the part. In a ferromagnetic material, as compared to a non-ferromagnetic material, the primary field results in a much greater internal field because of the large relative magnetic permeability. The increased field strength at the surface results in increased eddy current density. The increased eddy current density generates a larger secondary field that rapidly reduces the overall field strength a short distance from the surface. Consequently, the effective depth of penetration during ET is much less in ferromagnetic materials than in other conductive materials. The high relative magnetic permeability acts as a shield against the generation of eddy currents much below the surface in a ferromagnetic part. The relative effects of permeability variations on the depth of penetration and the intensity of the eddy currents are shown in [Figure 4-3](#).

4.1.6.3 Magnetic Permeability. Relative magnetic permeability is the principal property of ferromagnetic materials that affects eddy current responses. The relative permeability depends on a wide variety of parameters; alloy composition, degree of magnetization, heat treat, and residual stress, to name a few. Variations in permeability due to non-flaw conditions may mask effects from discontinuities or other conditions of interest. There are some situations where the permeability in the area of interest is not an interfering parameter and eddy current inspection can be successfully applied. An increase in conductivity or a decrease in permeability causes a decrease in measured impedance. Conversely, a decrease in conductivity or an increase in magnetic permeability causes an increase in measured impedance.



H0404497

Figure 4-3. Relative Magnitude and Distribution of Eddy Currents in Conductive Material of High or Low Permeability

4.1.6.4 Geometry. Eddy currents occupy a volume in a conductive material that is relatively small. As indicated in [Figure 4-2](#) and [Figure 4-3](#), the volume is approximately conical and not very deep. The maximum diameter will be on the order of twice the diameter of the driving coil (which can be reduced by shielding) and the depth is estimated by the equation discussed in Section 4.8. In this respect, part geometry only becomes significant when this volume exceeds the volume available within the part. This happens when the thickness of the region of the part inspected is less than the effective depth of this conical volume or when an area near edges of the part is inspected.

4.1.6.5 Lift-Off. As an eddy current probe is brought near a conductive part, you will note a change in the detected signal. With the probe near a part, a pronounced signal change will be observed in response to a small change in distance between probe coil and part. This effect is termed "lift-off." The signal change occurs because the intensity of the eddy currents in the part decreases considerably with a slight increase in coil-to-part spacing. This condition is demonstrated in [Figure 4-4](#). Calibrated measurements of lift-off can be used to determine the thickness of non-conductive coatings on conductive parts. Lift-off is discussed more in [Paragraph 4.3.14.8](#).

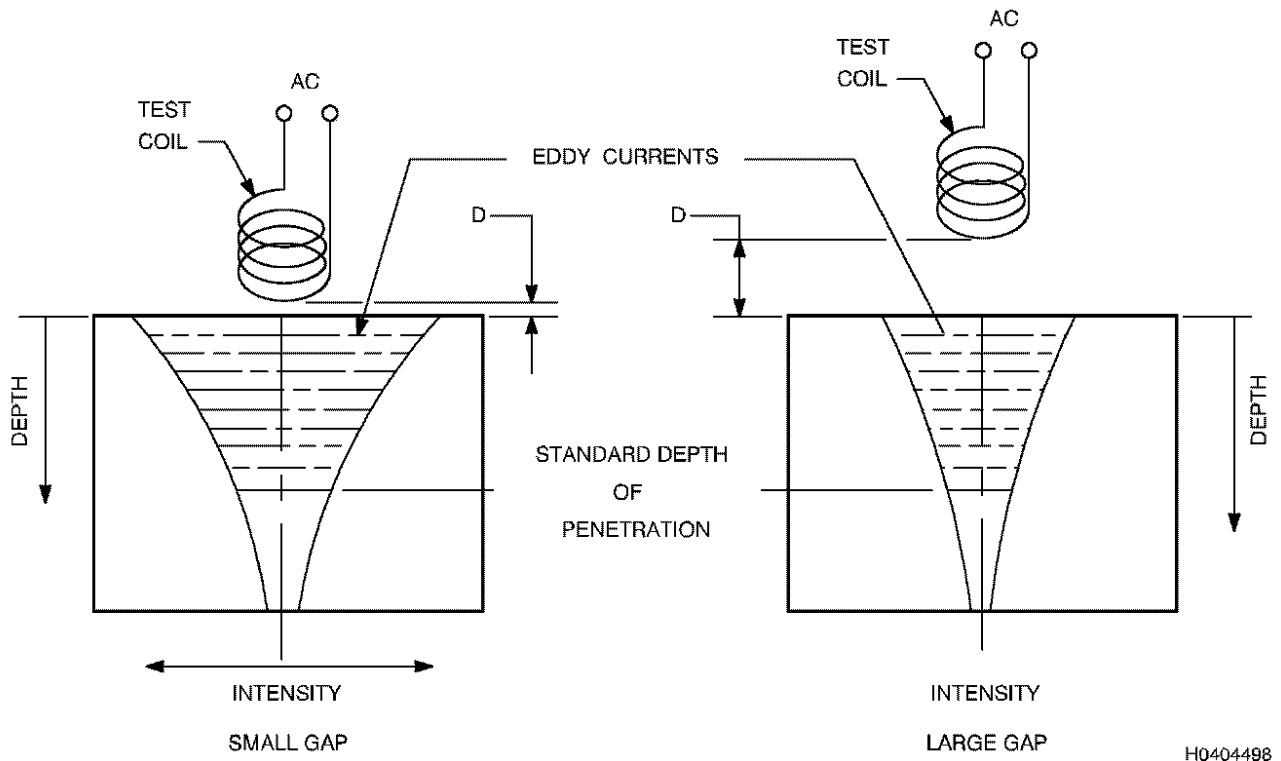
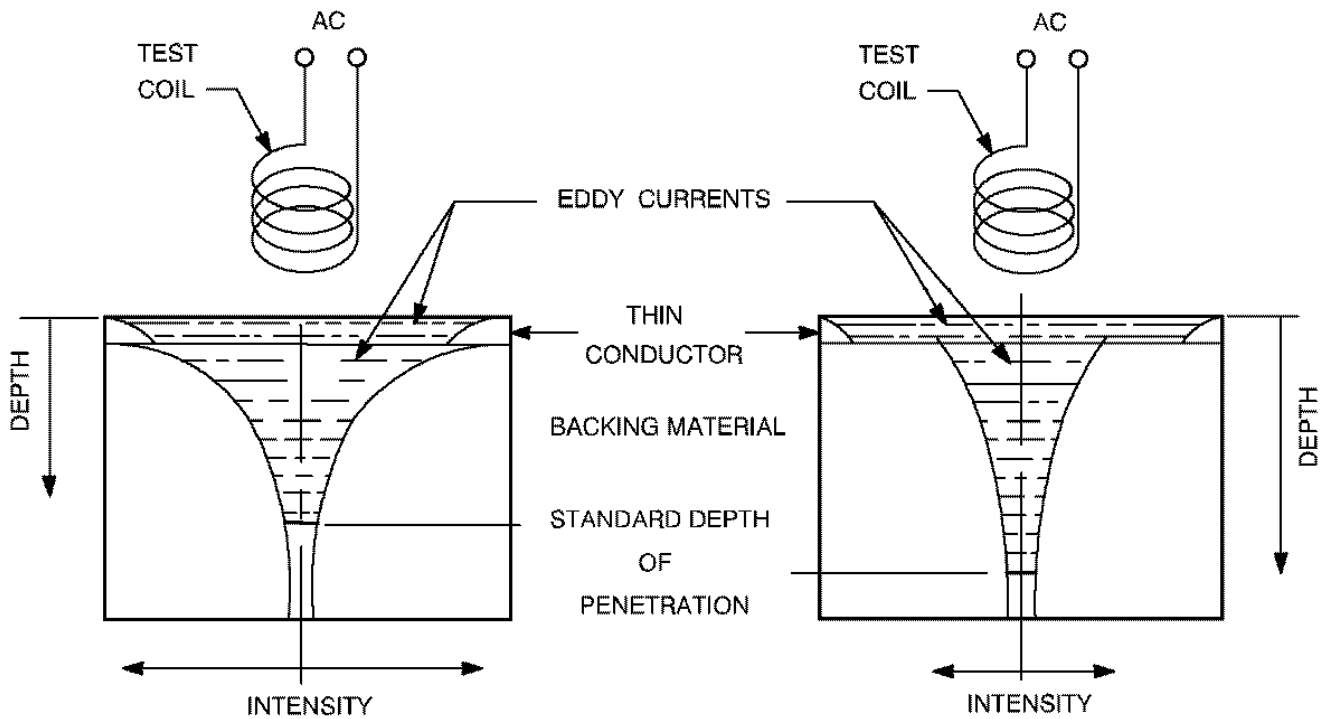


Figure 4-4. Relative Intensity of Eddy Currents With Variations in Lift-Off

4.1.6.6 **Material Thickness.** In sheet material with a thickness less than the effective depth of penetration (see [Paragraph 4.3.4.2](#)), the electromagnetic field is not zero at the back surface. As the thickness decreases, the field at the back surface increases. And, as the thickness increases, the back surface field decreases. This provides a mechanism for thickness gauging of thin materials. Furthermore, a material of either lower or higher conductivity at the far side will change the magnitude and distribution of the eddy currents as shown in [Figure 4-5](#). This provides a means for thickness gauging of thin, conductive coatings on underlying materials that are either more or less conductive than the coating.



H0404499

Figure 4-5. Distribution of Eddy Currents in Thin Conductors Backed by Materials of Different Conductivity

4.1.6.7 Heat Treat Condition or Hardness. Heat treating (or age hardening) a metal changes its hardness and its electrical conductivity. Just as above, the aluminum alloys have been the most investigated for the hardness/conductivity effect. Again, the impedance change is along the conductivity curve in the range of 25% to 65% International Annealed Copper Standard (IACS).

4.1.6.8 Temperature. Changing the temperature of a part changes its electrical conductivity. All metals become less conductive as temperature rises. This would be seen on the impedance plane as a movement along the conductivity curve toward the zero (air) end of the curve. For aluminum alloys, conductivity decreases about 1% IACS for a 20°F increase in temperature. If a conductivity meter is being used to check for proper alloy or heat treat condition, the temperature of all parts and calibration standards must be the same and kept constant. A change in temperature could be interpreted as a change in alloy or hardness, since all three factors may change the conductivity of a metal.

4.1.7 Eddy Current Techniques. There are a wide variety of Eddy Current techniques. A technique can be defined by the test frequencies, coil arrangements, data analyses, and data displays that are used. The techniques in [Table 4-1](#) are common applications used to measure or detect a variety of conditions. The table is categorized according to the actual material property or inspection parameter to be measured.

4.1.8 Field Application. The Eddy Current method is suited for detection of service-induced cracks in aircraft parts and related equipment. In addition, eddy current equipment is portable, with most systems using battery power. Eddy current applications are best suited for inspecting small localized areas. Scanning large areas for randomly oriented cracks is discouraged unless the system is automated. Eddy current can be more economical than other methods, because stripping and refinishing of surface coatings is not normally required.

SECTION II MATERIALS AND PROCESSES

4.2 MATERIALS AND PROCESSES.

4.2.1 Structure of Metals. The atoms of a chemical element have a nucleus or center with a positive charge. Around each nucleus are orbiting electrons. Each element has a different size nucleus surrounded by a characteristic number and arrangement of orbiting electrons. The distribution and number of the outermost electrons determine the properties of the element, including its metallic or nonmetallic nature. In a crystalline solid the atoms are stacked in an orderly arrangement called a lattice.

4.2.2 Mechanical Properties. Yield strength, tensile strength, and fatigue strength are determined by resistance to plastic deformation. Plastic deformation is permanent distortion of the metal and results from shearing along layers of atoms. Plastic deformation is made easier by the presence of localized imperfections in the lattice. These lattice imperfections are called dislocations and are present in great numbers in all commercial metals and alloys. If the resistance to movement of the dislocations can be increased, the strength of the metal can be increased.

4.2.3 Electrical Conductivity. Electrical conductivity is a measure of the ease with which electrons can move within a material. Good conductors of electricity have loosely bound electrons in the atomic lattice or crystalline structure and are relatively free of obstacles to the movement of those electrons. Metals have greater conductivity than nonmetals, but even within metals there is a wide range of conductivity. A perfect lattice is one in which there is no interruption in the orderly arrangement of the atoms making up the material. This situation offers the fewest obstacles to electron flow, and therefore, the highest conductivity. Any irregularity or distortion of the atomic lattice impedes the flow of electrons. Sources of such obstructions include atoms of alloying elements and grain boundaries (where lattice mismatches occur because of differing crystalline orientations). Additional obstructions are created when heat treat processes precipitate alloying elements at grain boundaries to increase strength. Cold working also creates obstructions to the flow of electrons, because of its disruption of the lattice structure. During NDI inspections it is important to note cracks and other discontinuities will also impede electron flow.

4.2.3.1 Conductivity and Mechanical Properties. The same variables of chemical composition, heat treatment, and metal working that determine the mechanical properties of a metal, also establish its electrical conductivity and magnetic permeability. As a result, correlation has been obtained between electrical conductivity and mechanical properties. This correlation does not mean the conductivity value of a metal will reliably measure its mechanical properties. However, for some metals, change of the measured conductivity from a specified conductivity range or excessive variation in conductivity within a given part or specimen indicates a probable change in properties. This change may be detrimental to the performance of the metal. It requires additional engineering investigation using hardness testing and other forms of testing to determine the magnitude of the change and disposition of the parts. The correlation of conductivity measurement with mechanical properties requires a clearly defined change in conductivity between the various alloys, tempers, or heat treatments involved. Differences in conductivity and/or permeability exist between alloys of many metals including aluminum, copper, magnesium, steel, and titanium. Not all alloys in each system are separable because of overlapping conductivity ranges. If one material has a relatively high conductivity and the other is relatively low within the given range, material separation is possible. Some metals have clearly defined differences in conductivity or permeability between the standard heat treat tempers. This situation exists for most structural aluminum alloys, many magnesium alloys, some copper alloys, and various steels. Little or no difference in conductivity is noted between the various heat treat conditions of titanium alloys.

4.2.4 Mechanical Properties of Pure Metals. A pure metal is one composed entirely of a single element. These metals are rarely used in structural applications and are usually difficult to prepare because of problems in removing all traces of other elements. They have relatively low resistance to deformation because there are few mechanisms to prevent the movement of dislocations through the metal. Two conditions can add to the strength of pure metals. Yield strength, which is a measure of the first detectable plastic deformation, can be increased very slightly by decreasing grain size. A grain is a small volume of the metal with the same three dimensional repetitive patterns of atoms. Most engineering metals are made up of a large number of grains fitted together along grain boundaries usually not visible to the unaided eye. Difference in lattice orientation in adjoining grains provides increased resistance to dislocation movement. A second strengthening mechanism for pure metals is cold working. Cold working multiplies the number of dislocations, and interaction between dislocations on different lattice planes increases the resistance to further deformation.

4.2.5 Alloys. Most engineering metals are alloys. An alloy is formed by adding one or more metals or non-metals to a base metal to form a metal of desired properties. Alloying elements are usually added during melting of a base metal and the quantities added are specified as a percentage range. The alloying elements can be in one or more forms in the solidified state depending on the amount added and the rate of cooling from the melting temperature. Some elements may occupy lattice

positions normally occupied by atoms of the principle element in the material. The alloy thus formed is called a substitutional solid solution. Very small atoms such as those of carbon, nitrogen, and hydrogen take up positions between the base metal atoms to form interstitial solid solutions. This action can actually change the lattice structure, an example being the addition of carbon to iron to form steel. Alloying elements can also form new lattice structures which are continuous throughout the metal or distributed as small particles of various sizes throughout the metal. The distribution of the alloying elements is dependent on the amount of alloying elements that are added in relation to the amount that can be tolerated in the lattice of the base metal and their change in solubility with temperature.

4.2.5.1 Alloy Effects on Mechanical Properties. All of the alloying element distributions increase the resistance of a metal to deformation. Increased strength results from the interference of the alloying atoms of particles formed by the alloying atoms with the movement of dislocations or by the generation of new dislocations. This distribution can often be modified by heat treatment.

4.2.5.2 Alloy Effects on Conductivity. The conductivity of a metal is decreased as increasing amounts of alloying elements are added. Even small amounts of foreign atoms can greatly reduce conductivity. Some alloying elements have a much greater effect on conductivity than others. Generally, atoms that most severely differ in size and electron distribution from the base metal cause the greatest decrease in conductivity. The lattice distortion caused by the alloying atoms and particles of different chemical composition inhibits the flow of electrons through the lattice. Because of variations in chemical composition resulting from the tolerances in alloy additions, a conductivity range rather than a specific conductivity value is obtained for each alloy.

4.2.6 Heat Treatment. The properties of metals can be altered by changing the number and distribution of dislocations, alloying atoms, and particles of different composition. These changes can be accomplished through various types of heat treatment. The three principal types of heat treatment are: (1) annealing, (2) solution heat treatment, and (3) precipitation heat treatment or artificial aging.

4.2.6.1 Annealing. In annealing, the metal is heated to a sufficiently high temperature to remove the effects of cold working by redistribution of dislocations and, in some instances, by the formation of new stress-free grains (re-crystallization). During the annealing of alloys, the temperature is selected sufficiently high to permit the alloying atoms to readily migrate. However, this selected temperature is sufficiently below maximum solubility to favor the formation of separate particles and compounds by the alloying atoms. Slow cooling from the annealing temperature encourages even more alloying atoms to move from their random position in the base metal lattice to aid in the growth of larger secondary compounds.

4.2.6.1.1 Annealing Effects on Mechanical Properties. Annealing removes many of the obstacles to plastic flow, such as interacting dislocations, the numerous individual alloying atoms, and fine particles that normally resist plastic deformation. These processes generally result in metals of lower strength and greater ductility after annealing.

4.2.6.1.2 Annealing Effects on Conductivity. The annealing process reduces obstacles to electron flow. Therefore, annealing improves the conductivity of a metal.

4.2.6.2 Solution Heat Treating. The minimum number of alloying atoms will occupy lattice sites of the base metal when a temperature slightly below melting point is reached. In interstitial solid solutions, the maximum number of atoms will occupy interstitial positions. As temperatures are lowered, the atoms of many alloying elements will tend to diffuse together and form separate compounds or regions with a different lattice. If the metal is cooled rapidly, the atoms do not have time to diffuse and are held in their original lattice positions (retained in solution). The process is called solution heat treating. Any delay in rapid cooling (delayed quench) or a slow rate of cooling will permit an increased amount of diffusion and reduce the number of alloying atoms held in solution.

4.2.6.2.1 Solution Heat Treating Effects on Mechanical Properties. The alloying atoms retained in base metal lattice positions by solution heat treating present obstacles to dislocation movement. The resistance to plastic deformation increases the strength of the metal. In many instances, more than one alloying element contributes to the higher strength of alloys. Slow rates of cooling from solution heat treating temperatures or too low a solution heat treating temperature can reduce the strength of the heat treated alloy.

4.2.6.2.2 Solution Heat Treating Effects on Conductivity. The distortion and stresses established by the substitution of alloying atoms for those of the base metal reduce the conductivity of the metal. The greater the number of solute atoms of a specific material, the greater the reduction there will be in conductivity. The presence of lattice vacancies, caused by solution heat treating, also disrupts the electronic structure of an alloy and contributes to lower conductivity.

4.2.6.3 Precipitation Heat Treatment. If an alloy has been solution heat treated to retain atoms in the same lattice occupied at high temperature, properties can be further modified by a precipitation or aging treatment. During a precipitation treatment, an alloy is heated to a temperature which will allow alloying atom diffusion and coalescence to form microscopic particles of different composition and lattice structure within the metal. The number, size, and distribution of the particles are controlled by the time and temperature of the aging process. Temperatures are much lower than those required for solution heat treating or annealing. Lower temperatures and shorter times result in smaller particle sizes. Higher temperatures favor the formation of fewer but larger particles.

4.2.6.3.1 Precipitation Treatment Effects on Mechanical Properties. Precipitation or aging treatments are generally designed to increase the strength of alloys, particularly the yield strength. The strengthening is accomplished by the formation of small particles of different composition and lattice structure from the original lattice. The small particles provide obstacles to the movement of dislocations in which planes of atoms slip one over the other causing plastic deformation. Greatest strengthening usually occurs at a specific range of particle size for a particular alloy system. In many cases, aging is performed under conditions designed to provide a specific combination of strength and ductility, or corrosion resistance. As aging increases beyond the optimum time or temperature, particle size increases and gradual softening occurs. When material has been aged for an excessive time or at too high a temperature, it is said to be over-aged.

4.2.6.3.2 Precipitation Hardening Effects on Conductivity. The removal of foreign atoms from the parent lattice during precipitation hardening removes much of the distortion of the electron distribution in the lattice. This action favors the movement of electrons through the metal and results in higher conductivity. As increased amounts of foreign atoms are removed from solution and particle growth occurs during over-aging, conductivity continues to increase.

4.2.7 Measurement of Mechanical Properties. The most common method of determining the strength of metals is by means of a tensile strength test. In the tensile strength test, a specimen is cut from the metal to be tested, machined to a specified configuration, and tested until it fails. This is accomplished by applying a known tensile force. Tensile force is the stress at which a known amount of plastic deformation occurs, and the breaking stress can then be determined. Many other destructive type tests can be performed to establish such properties as impact resistance, notch sensitivity and fatigue strength. All of these methods require destroying a section of the part to be tested and involve considerable time and expense.

4.2.7.1 Hardness Testing. An approximate measure of strength of metals may be established by hardness testing. Hardness is usually determined by the resistance of a metal to penetration by a rounded or pointed indenter pressed into the surface with a known static force. Measurement of hardness is based on the depth of penetration of the indenter, or the plane area of the indentation. For many metals, correlation has been established between hardness and tensile strength. Hardness supplies no information regarding ductility although portable hardness testers are available; access and geometry often limit their use.

SECTION III EDDY CURRENT PRINCIPLES AND THEORY

4.3 PRINCIPLES AND THEORY OF EDDY CURRENT INSPECTION.

4.3.1 Induction of Eddy Currents. As the electromagnetic field from a coil penetrates a conductor, it generates eddy currents parallel to the surface of the part and at right angles to the direction of the applied field ([Figure 4-6](#)). The frequency of eddy current flow is the same as the electromagnetic field.

4.3.2 Primary Electromagnetic Field. The primary electromagnetic field is the coil's magnetic field ([Figure 4-6](#)). This field is called electromagnetic because the magnetic field is produced from electricity rather than from a permanent magnet. The rate at which the electromagnetic field varies is called the frequency. The strength of the electromagnetic field at the surface of the conductor depends on the coil size and configuration, the amount of current through the coil, and the distance from the coil to the surface. The amount of eddy currents the primary field is able to generate is dependent upon the properties of the part under test and the strength of the secondary electromagnetic field that opposes the primary field.

4.3.3 Secondary Electromagnetic Field. Eddy currents also generate an electromagnetic field in the part. This field, called the secondary electromagnetic field, opposes the primary electromagnetic field ([Figure 4-6](#)) and is a consequence of Lenz's Law. Lenz's Law, as applied to this case, states induced currents (eddy currents) act to reduce the magnitude of the inducing current. The opposition of the secondary field to the primary field decreases the overall electromagnetic field strength and reduces both the current flowing through the coil and the resultant eddy currents. Changes to the properties of the inspection article produce changes to the eddy currents and thus their secondary magnetic fields. In this manner, changes in

the inspection article produce effects that can be detected by monitoring either the source of the primary electromagnetic field or the overall electromagnetic field.

4.3.4 Depth of Penetration. The intensity of eddy currents decreases exponentially with depth in a material. The intensity at any given depth is affected by the same variables that influence the surface intensity of eddy currents, although not always in the same manner or by the same amount. To put it another way, the depth of penetration of a specific intensity of eddy currents is affected by the variables, as indicated in [Table 4-3](#) in [Paragraph 4.8](#). Generally, any parameter that increases the depth of penetration would increase the detectability of discontinuities deeper in the part.

4.3.4.1 Standard Depth of Penetration. Three of these variables (conductivity, relative magnetic permeability, and frequency) are used to define the standard depth of penetration. Standard depth of penetration is the depth below the surface of the inspection article at which the magnetic field strength, or the intensity of the induced eddy currents, is reduced to 36.8-percent of the value at the surface. The standard depth of penetration is expressed by the following formula in [Paragraph 4.8.7](#). Since the depth of penetration is related only to a percentage of surface field strength (eddy current intensity) some test variables are not included in the formula. Coil configuration, size, current, and magnetic coupling are not considered in this formula. These variables affect the absolute magnitude of the eddy currents at a specified depth but not the standard depth of penetration. The standard depth of penetration values for select frequencies for various alloys, bare aluminum alloys, and clad aluminum alloys are shown in [Table 4-5](#) and [Table 4-6](#) in [Paragraph 4.8](#).

4.3.4.2 Effective Depth of Penetration. Effective depth of penetration is the depth in the inspection article at which the magnetic field strength or the intensity of the induced eddy currents is reduced to 5-percent of the value at the surface. This depth is approximately 3 times the standard depth of penetration (According to ASTM E1004, the effective depth of penetration used for the purposes of conductivity testing is 2.6). The effective depth of penetration is used to determine test frequency when working with thin materials, so the overall electromagnetic field does not extend beyond the back surface of the test part so thickness variation effects can be suppressed. The minimum material thickness required for conductivity testing various alloys at 60 kHz and 480 kHz using the ASTM values of 2.6 is shown in [Table 4-3](#) in [Paragraph 4.8](#).

4.3.4.3 Temperature and Depth of Penetration. For most applications, temperature is not a major factor in determining depth of penetration. However, if necessary the effects of temperature would be included as adjustments to the values for conductivity and relative magnetic permeability used in the formula to calculate the standard depth of penetration.

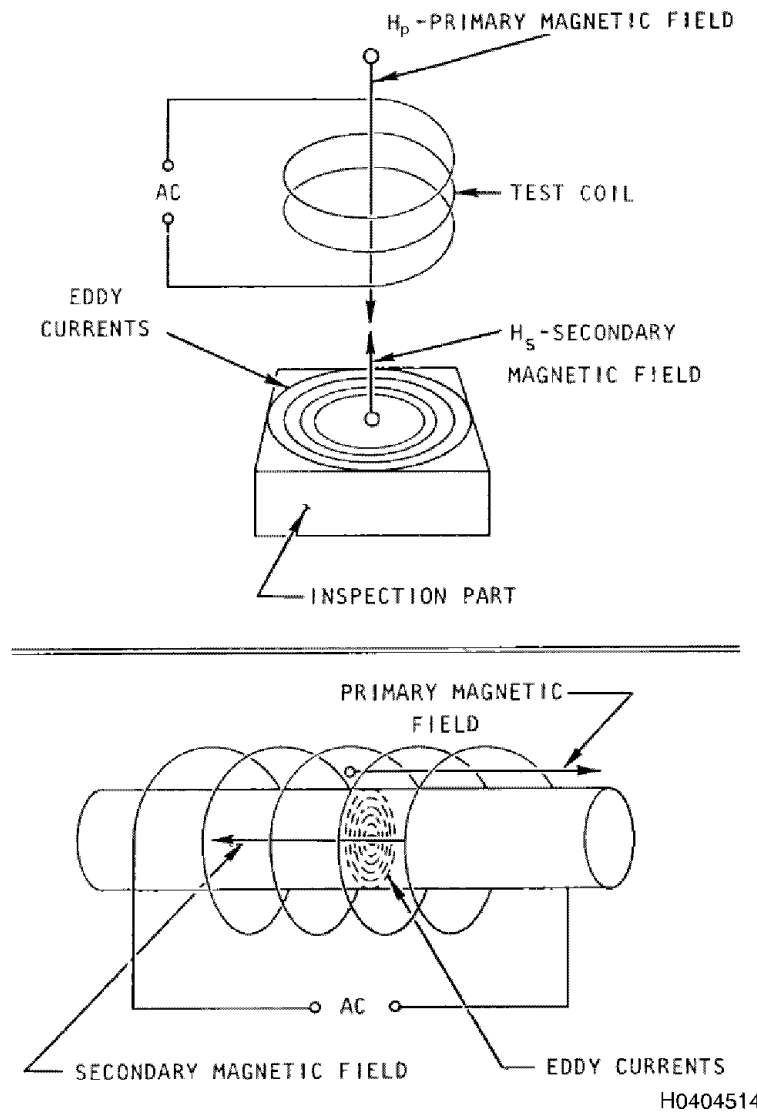


Figure 4-6. Primary and Secondary Magnetic Fields in ET

4.3.5 **Impedance.** Impedance is the total opposition to the flow of current represented by the combined effect of resistance, inductance and capacitance of a circuit.

4.3.6 **Sensitivity.** The ability of an eddy current instrument to detect small variations in test coil impedance is a measure of its sensitivity. This quality is interrelated with the properties of the test coil and the operating frequency. Therefore, instrument sensitivity to a particular flaw condition or material property SHALL be established from reference standards representing this condition.

4.3.7 **Resolution.** The ability of a test system to separate the signals from two indications that are close together is defined as "resolution." This property plus sensitivity must be considered in every flaw evaluation situation. Probe design, test frequency, and instrumentation design are all factors in determining the resolution of an eddy current system.

4.3.8 **Measurement of Resistivity.** Electrical resistance is a measure of the resistance to the flow of electric current in a conductor. Resistance depends on the length and area of the current path, and the conductivity of the conductor. Resistance is commonly measured in ohms. If a material allows one volt (electric potential) of driving force to push one ampere of current through a conductor, the electrical resistance of the conductor is defined as one ohm of resistance. Resistivity is a mate-

rial parameter independent of the size of a material sample and is related to resistance. Resistivity is defined as ohms times cross-sectional area divided by unit of length ([Paragraph 4.8.1.3](#)).

4.3.9 Measurement of Conductivity. Electrical conductivity is the reciprocal of electrical resistivity. The reciprocal of the "ohm" is commonly called the "mho." Conductivity is commonly expressed in units of mho's per unit length; such as mho/inch or mho/meter. The relationships between conductivity, resistivity, and resistance are expressed by the equations in [Paragraph 4.8.12](#).

4.3.9.1 Conductivity Based on the Percentage of International Annealed Copper Standard. (%IACS). An alternative way of expressing conductivity is a percent of the conductivity of a known material. The International Electrotechnical Commission has designated the conductivity of a specific grade of high purity copper to be the standard for this alternative method with a conductivity of 100-percent. It is called the International Annealed Copper Standard (IACS). The conductivity of all other metals is then expressed as a percentage of this standard.

NOTE

Values of conductivity of some commonly used engineering materials are listed in [Table 4-2](#) and [Table 4-7](#) in [Paragraph 4.8](#). Percent IACS is the usual way of expressing conductivity in aerospace NDI.

4.3.10 Overview of Signal Detection, Processing, and Display.

4.3.10.1 Signal Sources. When performing an eddy current technique, material changes can be detected by monitoring the alternating current in the coil (single coil arrangement) or using a separate sensing coil to monitor the resultant electromagnetic field. These signals can be analyzed for information relevant to the inspection being conducted. The important thing to note is the coil that is acting as the receiver is producing an electrical current that either leads or lags the instruments oscillator current. The difference in this "leading" or "lagging" is the phase angle.

4.3.10.2 Signal Detection. A simple but effective signal detection technique is to use a bridge circuit as illustrated in [Figure 4-7](#). With current flowing through the test coil and the coil positioned on a flaw-free or reference area, the variable impedance Z_1 can be adjusted so zero current flows through the amplifier. This adjustment is termed either "balancing" or "nulling" the bridge. When the coil is placed on a flawed or damaged area, the resultant change in current through the coil "unbalances" the bridge and current flows through the amplifier. This current is the inspection signal. The signal has the same frequency as the current through the coil. The phase and amplitude of this signal contains information on the condition that caused the bridge unbalance.

4.3.10.3 Signal Analysis. In the simplest type of instrumentation, analysis of the signal consists of measuring the change in magnitude of the current flowing through the bridge. Changes in the magnitude of the alternating current are amplified and converted to a direct current for display or readout. In more sophisticated instrumentation, both amplitude and phase are measured.

4.3.10.4 Displays. The method by which eddy current signals are presented is dictated by the type of information required and the complexity of the instrumentation. When only signal amplitude is measured, meters, alarm signals, or recorders are commonly used. When both amplitude and phase information are to be displayed, a two-dimensional display device is normally used.

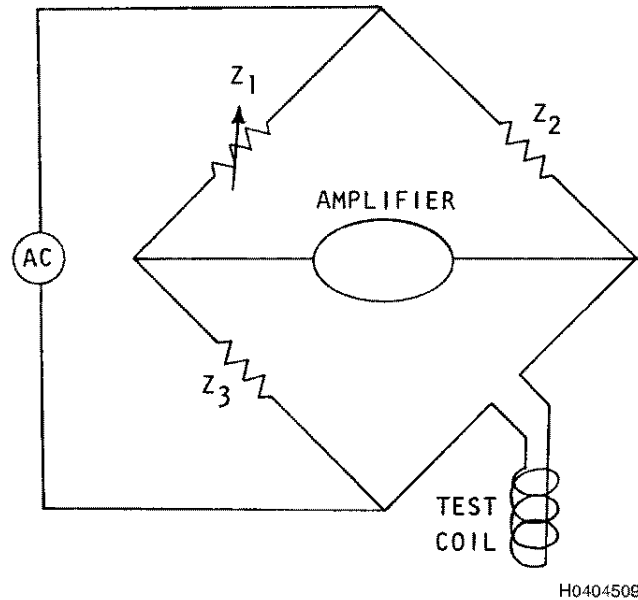


Figure 4-7. Simplified Bridge Circuit

4.3.10.4.1 Amplitude Display. Meters may be analog (needle moving over a fixed numerical scale) or digital. Audible or visual alarms may be set to trigger when the signal amplitude exceeds a predetermined threshold. A recorder presents a continuous record of the signal amplitude during an inspection for subsequent analysis.

4.3.10.4.2 Impedance Plane Display. Defects or other variations in material characteristics will alter the strength and distribution of an induced eddy current flow. Changes in the eddy current flow will result in changes in the inducing coil or sensor coil currents. These changes can be expressed as an apparent change in the coil's electrical impedance. This makes it possible to associate changes in material properties with specific changes in the apparent impedance of either the excitation or sensor coils. The two-dimensional display that permits this is the most commonly used and is called an impedance plane display. The impedance plane is discussed further in [Paragraph 4.3.10.8.2](#).

4.3.10.5 Impedance Changes. The impedance of a coil appears to change when it is placed adjacent to an electrically conductive or ferromagnetic part. The secondary electromagnetic field created by the induced eddy current in the part opposes the primary field. This opposing field also induces a current flow in the coil in opposition to the primary current. If the part is not ferromagnetic, the net magnetic field resulting from the combination of the primary and secondary fields is decreased in magnitude, as is the current flow in the coil. This is equivalent to decreasing the inductance and increasing the resistance of the coil. If the part is ferromagnetic, the net magnetic field is increased because of the magnifying effect of the relative magnetic permeability, but the current flow in the coil is decreased because of the opposing effect of the secondary magnetic field from the induced eddy currents. This is equivalent to increasing both the inductance and resistance of the coil. In this manner changes in a part that affect either the strength of the magnetic field at the surface of the part or the strength and distribution of the eddy currents in the part, change the apparent impedance of the test coil(s). These variations in current flow, both phase and amplitude, can be detected, amplified, displayed, and analyzed as eddy current test results. The amplitude and phase changes in the signals can be related to changes in the parts inspected.

4.3.10.6 Inductance of a coil. The inductance of a coil depends upon the number of turns in the coil, the size of the coil, the permeability of the material within the coil (e.g., the core of the coil), and total magnetic flux through the coil. An alternate method of expressing self-inductance (L) is:

$$L = n \Phi / I$$

Where:

- L = Inductance (henry)
- n = Number of turns in coil
- Φ = Magnetic flux (weber)
- I = Current through coil (ampere)

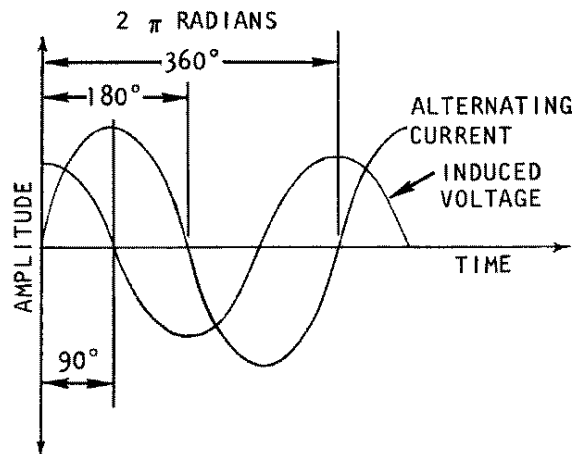
4.3.10.7 **Inductive Reactance.** The measure of the amount of opposition or resistance (ohm) to alternating current flow due to inductance in a coil is called inductive reactance. Inductive reactance is dependent upon the value of the inductance of the coil and the frequency of the alternating current. The inductive reactance increases as the inductance or frequency increases. This can be stated by the following equation:

$$X_L = 2 \pi fL$$

Where:

- X_L = Inductive reactance (ohm)
- $\pi = 3.141596$
- f = frequency (hertz)
- L = Inductance (henry)

4.3.10.7.1 The inductive reactance results from the electromotive force generated across a coil by the alternating current. The instantaneous value of this induced voltage, increases and decreases as the rate of change of the applied alternating current increases and decreases as shown in [Figure 4-8](#). The voltage is at its maximum value when the rate of current change is at its maximum; this occurs when the current value is at zero. Conversely, the voltage is zero when the rate of current change is zero; this occurs when the current is at its maximum value. Considering 360-degrees to be one complete cycle, the induced voltage leads the current (e.g., is out of phase with the current) by 90-degrees as illustrated in [Figure 4-8](#). The induced voltage is in opposition to the electromotive force applied to the coil, reducing the amplitude of the resultant current.



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Figure 4-8. Sinusoidal Variation of Alternating Current and Induced Voltage in a Coil

4.3.10.8 **Combining Out of Phase Quantities.** A real coil has a resistive component of the impedance in addition to the inductive reactance. They can be combined to describe the net impedance. A coil can be considered to be a resistor in series with an inductor. Applying an alternating current to this series circuit will result in two voltages, one across the resistor and another across the inductor. The net voltage across the combination of the resistor and inductor (e.g., across a real coil), will be the combination of the two voltages. The voltage across the resistor will be in phase with the current while the voltage

across the inductor will lead the voltage across the resistor by 90-degrees. The combination of the two voltages, as illustrated in [Figure 4-9](#), results in a voltage that will be out of phase with the current but not by a full 90-degrees.

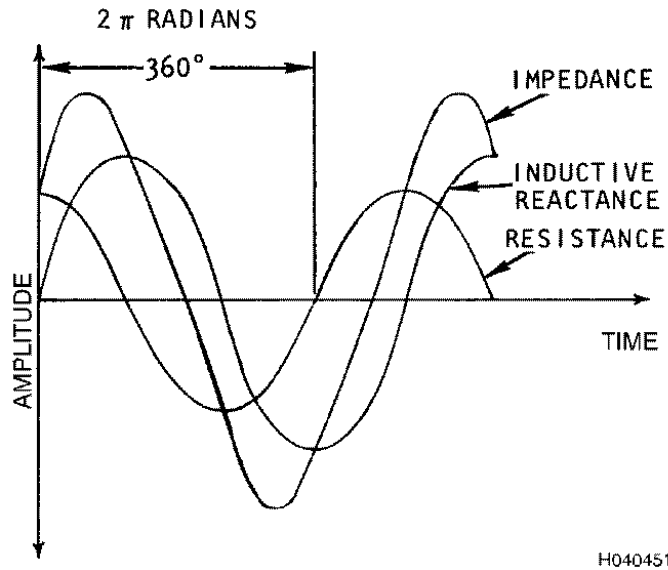


Figure 4-9. Combining of Out-of-Phase Voltages

4.3.10.8.1 **X-Y Plot Representation.** Another way to illustrate the combination of out-of-phase quantities in a coil is illustrated in [Figure 4-11](#). Here the two voltages drop; one across the resistor (V_R) and the other across the inductor (V_L) are plotted at right angles to each other. This represents the two quantities being 90-degrees out of phase. The combination of the two quantities is represented by the diagonal line OA that is at the angle " θ " with respect to the voltage drop across the resistor.

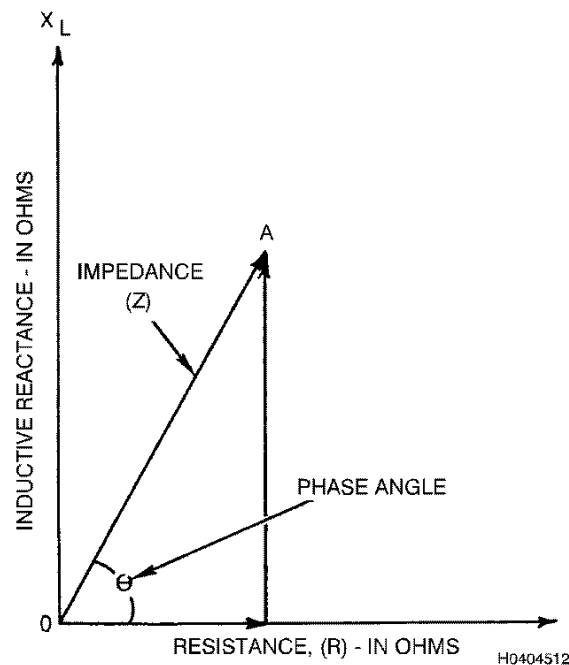


Figure 4-10. Vector Diagram Showing Relationship Between Resistance, Reactance, and Impedance

4.3.10.8.2 Impedance Plane Representation. Just as the two voltages can be combined to produce the net voltage across a coil (Figure 4-11); the resistive and inductive impedance components can be combined to produce the net impedance of a coil. In Figure 4-10, inductive reactance (X_L) is plotted on the y-axis and resistance (R) is plotted along the x-axis. These two values define the impedance that is represented by the vector OA. The value of the angle " θ " for the net impedance is the same as the angle " θ " illustrated in Figure 4-11 for the net voltage. This is important because it shows that the impedance of a coil can be displayed as the combination of two out-of-phase voltage drops. The amplitude of the impedance may be determined from the known values of resistance and inductive reactance according to the following formula:

$$Z = (X_L^2 + R^2)^{1/2}$$

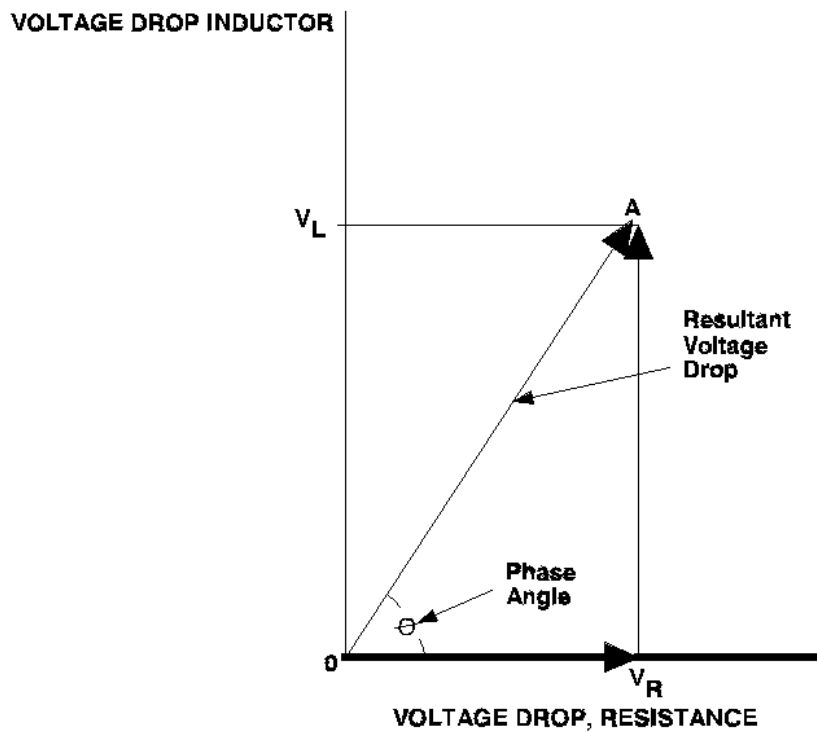
Where:

Z = Impedance magnitude (ohms)

X_L = Inductive reactance (ohms)

R = Resistance (ohms)

X_c = 0 Capacitive reactance is negligible.



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Figure 4-11. Diagram Showing Relationship of Voltage Drops Across Coil Resistance and Coil Reactance

4.3.10.8.3 The phase angle (θ) of the impedance can be calculated from the values of resistance and inductive reactance as follows:

$$\tan \theta = X_L / R$$

Where:

θ = Phase angle (degrees)

X_L = Inductive reactance (ohms)

R = Resistance (ohms)

4.3.11 Impedance Diagrams.

4.3.11.1 Purpose. The impedance diagram shows how changes in eddy current test variables change the apparent impedance of a coil. Typical variables displayed are electrical conductivity, relative magnetic permeability, fill-factor or lift-off, part thickness, and test frequency. Impedance diagrams are very useful in determining optimum inspection parameters and understanding eddy current results when more than one variable is changing. The vector representation of inductive reactance on the y-axis and resistance on the x-axis of [Figure 4-12](#) is the basis of the impedance diagram. Let point A represent the impedance of a test coil while on a part. If the probe is moved to a place on the part with a flaw, the impedance will change. This new impedance can be represented by the point B, as shown in [Figure 4-12](#). Each change in the impedance will create a new point on the diagram.

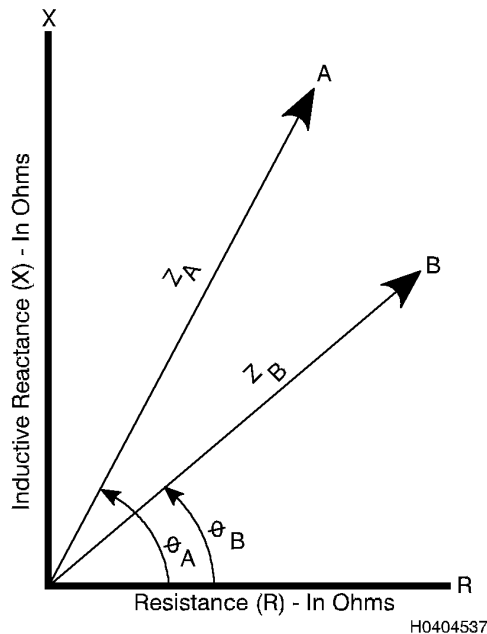


Figure 4-12. Vector Representation of Impedance

4.3.11.2 Development of an Impedance Diagram. To make the impedance diagram into a useful tool for understanding eddy current testing, it is necessary to systematically change a single test parameter such as conductivity, and observe the changes in the impedance. Using an eddy current instrument with a two-dimensional graphical display, a surface probe, a piece of ferrite (a nonconductive, ferromagnetic ceramic) and several nonmagnetic metal specimens representing a range of conductivity's from low (titanium, Inconel) to high (copper, silver), approximate impedance diagrams can be developed and demonstrated. The specimens must have clean, flat, and bare surfaces. When the eddy current probe is held away from the part (in the air) and the instrument is nulled, an indication (dot) will appear on the display. The null point can be repositioned near the upper left hand corner of the display, as indicated by point A in [Figure 4-13](#) and [Figure 4-14](#). The null point in air will be used as a point of reference for the rest of the diagrams. Next, the ferrite specimen is used to establish the direction of in-

ductive change. Place the probe on the ferrite and adjust the phase control so that the change from air to ferrite is vertical (parallel to the y-axis). When the probe is placed on the copper specimen, the point will move to a new location on the screen, represented by point I in [Figure 4-14](#). As the probe is lifted from the specimen, the point will move back to the air null point (A), as shown in [Figure 4-13](#) and [Figure 4-14](#). The path that the indication follows as the probe is moved onto and off the specimen is called the lift-off trace/line.

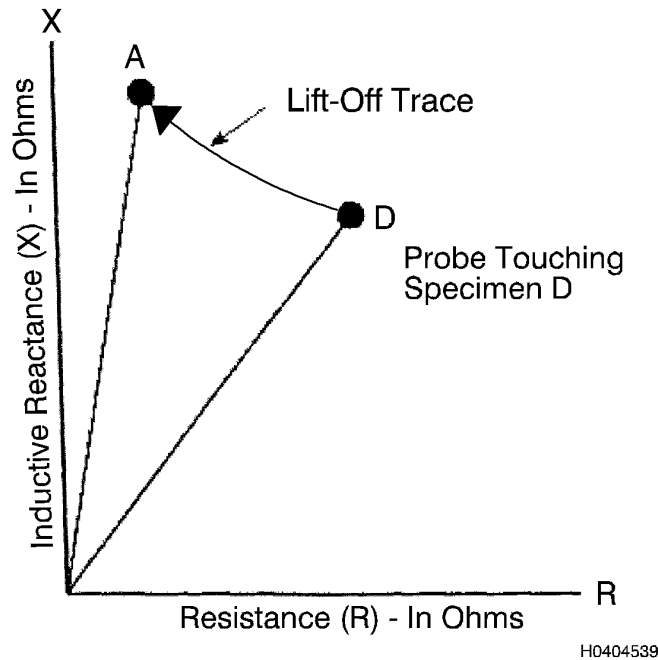
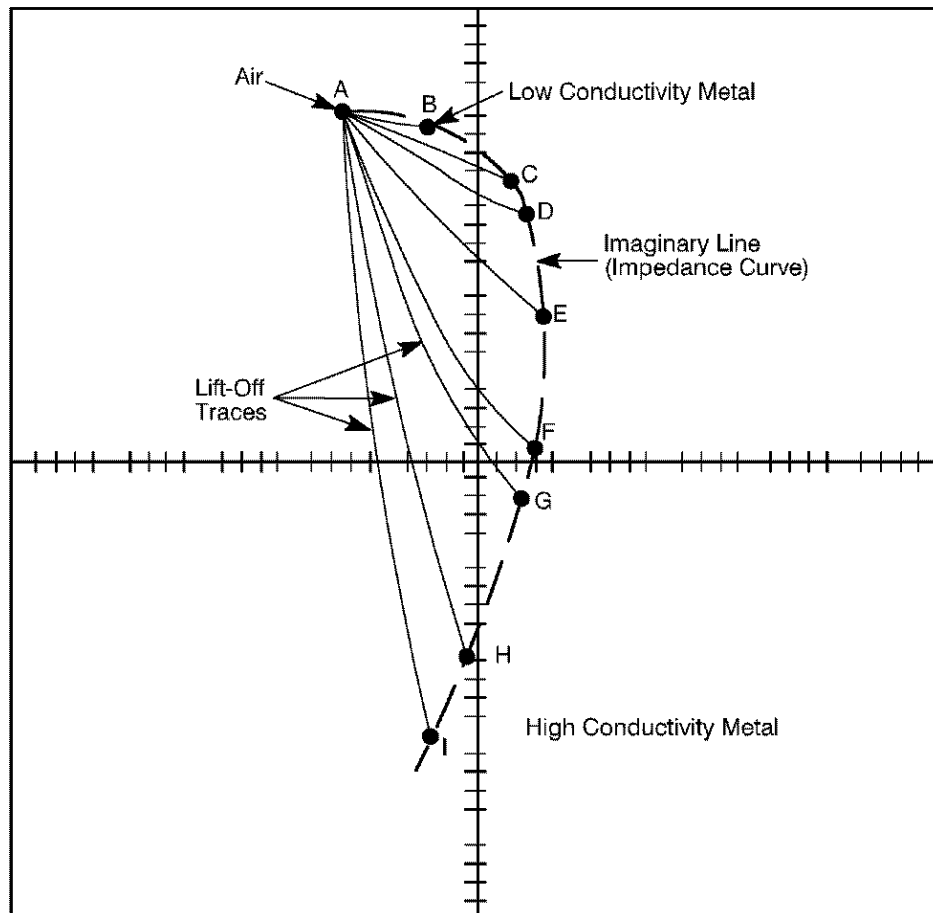


Figure 4-13. Vector Representation of an Impedance Change due to Lift-Off

4.3.11.3 Typical Uses of an Impedance Diagram. The impedance diagram (shown in [Figure 4-14](#)) illustrates the conductivity curve can be used to measure the relative conductivity of an unknown material by comparing the position of its indication on the conductivity curve to the positions of indications from known materials. Notice also the lift-off lines are in a different direction than the conductivity line. Changes in conductivity and lift-off are said to have different phase angles. This phase angle difference is further illustrated in [Figure 4-15](#). The lift-off curve can also be used to measure the thickness of non-conductive coatings on a conductive surface. This is done by comparing the length of lift-off line for an unknown coating thickness to the lengths of lift-off lines for known thickness.



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Figure 4-14. Impedance Diagram Illustrating Effects of Variable Conductivity

4.3.11.4 Conductivity Curve. The gain and phase controls can be adjusted to place point I anywhere on the display. Because copper has high conductivity, it will be convenient to adjust the gain to put point I in the lower part of the screen, ([Figure 4-14](#)). When the probe is placed on the other metal samples, the respective impedance points “B through H” ([Figure 4-14](#)) are recorded. Note for each of the different materials, the point will be located at a different location on the screen (e.g., each different specimen has a different impedance). Each line from the null point A, to the impedance point for a particular specimen represents a liftoff trace. If a smooth curve is drawn from the null point A through each of the impedance points B through I, a conductivity curve will be formed. The point on the curve closest to the air null point represents the material with the lowest conductivity (e.g., titanium). The point on the curve farthest from the air null point represents the material with the highest conductivity (high purity copper). This diagram also shows the relative conductivity of the other specimens.

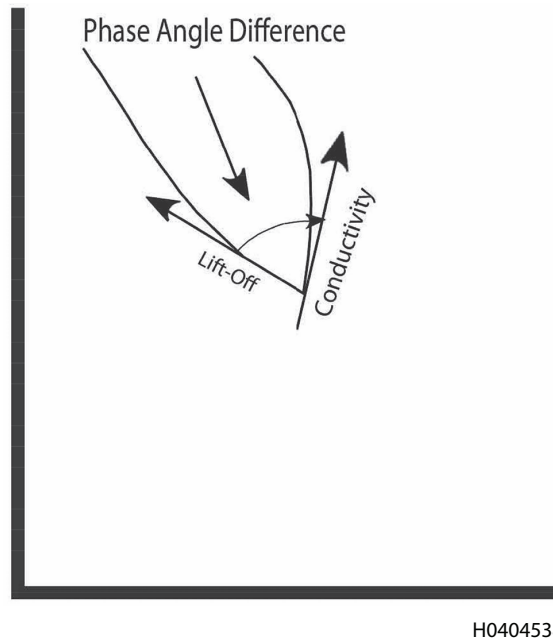
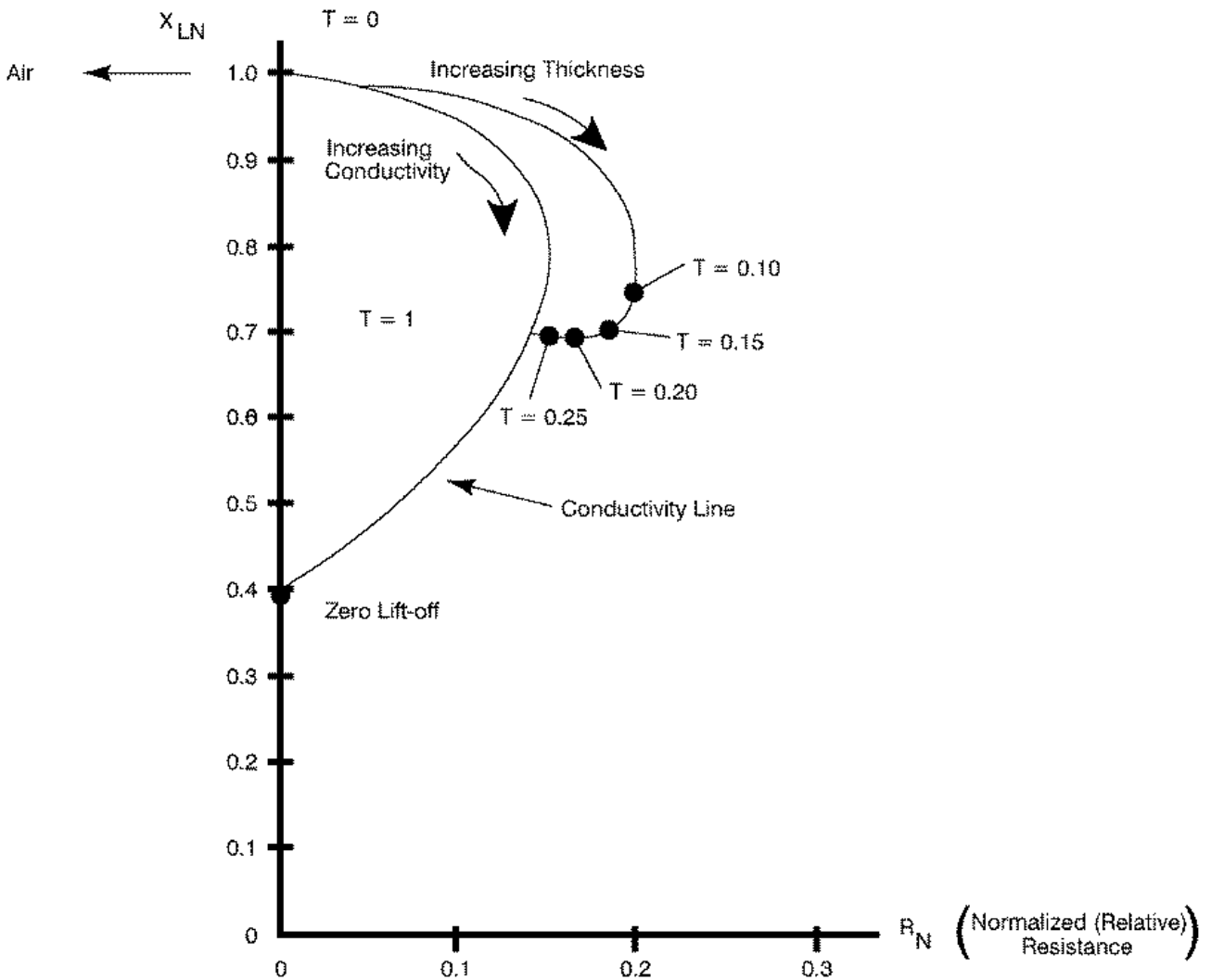


Figure 4-15. Phase Angle Difference

4.3.11.5 Thickness Variations. When the part thickness is less than the effective depth of penetration of the test coil at the inspection frequency employed, the impedance curve departs from the conductivity curve as shown in [Figure 4-16](#). Typically, there is an increase in the resistive component of the impedance with thinner parts, as compared to parts that have thickness equal to or greater than the effective depth of penetration. As the thickness of the parts increase and approach more closely the effective limit of penetration, the curve tends to spiral as it approaches the end point ($T=1$) on the conductivity curve, where T equals the ratio of the specimen thickness to the effective depth of penetration in that specimen.



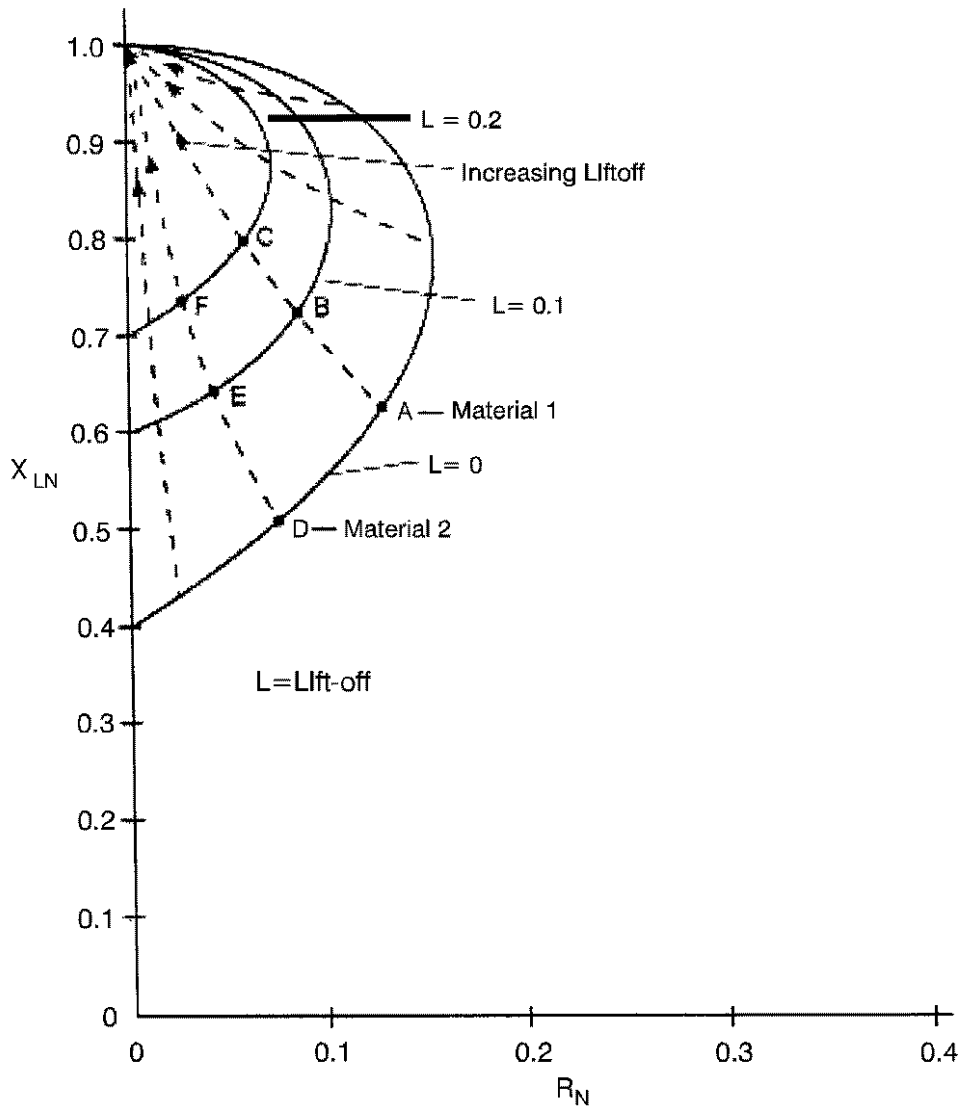
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Figure 4-16. Impedance Diagram Showing the Effect of Specimen Thickness

4.3.11.6 Conductive Layers. The impedance curve for thin conductive layers on a substrate of different conductivity is also represented as a change in the impedance curve for conductivity. The impedance for the layered material departs from the conductivity curve at the value corresponding to the substrate conductivity and forms a loop that rejoins the conductivity curve at the conductivity of the metal in the outer layer. Increasing thickness of the outer layer corresponds to a clockwise direction along the loop. The point at which the loop rejoins the curve represents the effective depth of penetration in the outer layer.

4.3.11.7 Normalization of Impedance. To illustrate general principles of eddy current inspection or to present data in a universal form independent of specific coil impedance values, impedance diagrams are usually normalized. In normalization, the inductive reactance and the resistance of the coil on the part are divided by the value of the inductive reactance of the coil in air. Therefore, the vertical axis of the impedance diagram equals the relative inductive reactance (X_{LN}) of the test coil; and the horizontal axis of the impedance diagram equals the relative resistance (R_N) of the test coil. Normalization is a convenient method to allow comparisons of eddy current data from a large number of tests using different probes and materials. The shapes of the impedance diagrams remain the same. However, the air null point A in [Figure 4-17](#) becomes 1 on the

y-axis of the impedance diagram after normalization. The impedance diagrams in this manual will all be represented by the normalized reactance (X_{LN}), on the y-axis and normalized resistance (R_N) on the x-axis.



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Figure 4-17. Impedance Diagram Showing the Effect of Lift-Off

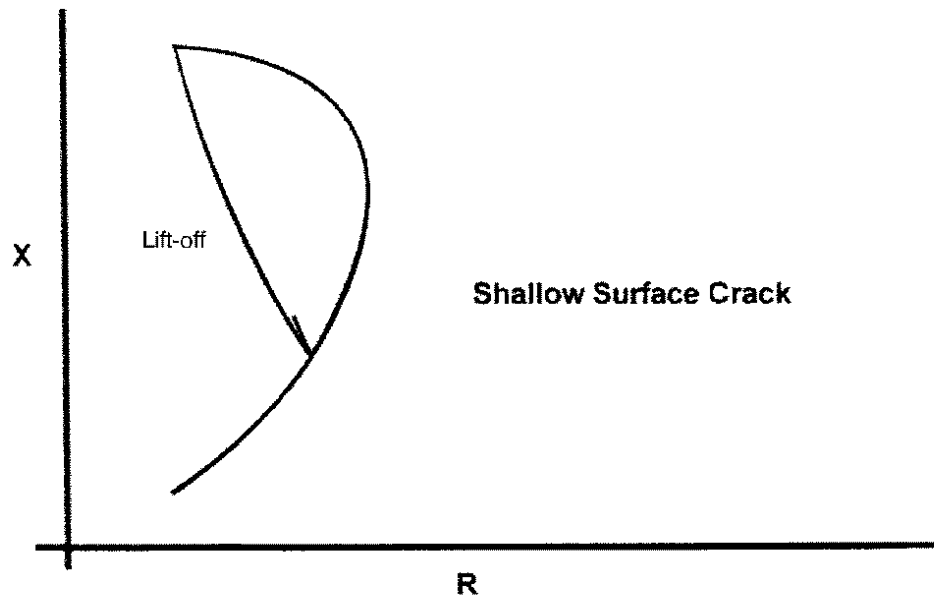
4.3.12 Impedance Plane Analysis. Most eddy current applications have two major problems to overcome. The first is to ignore changes in parameters not of interest during the test; an example is lift-off variation while inspecting for cracks. The second is to recognize valid indications while other changes are occurring. Another way of stating this is insignificant variations such as those associated with lift-off should not be mistaken for valid defect indications, and valid defect indications should not be hidden by nonrelevant changes such as lift-off. Impedance plane analysis, also called phase analysis, is a tool that is effective in solving these problems.

4.3.12.1 Phase Detection. Phase angle measurements are a good way to detect a variety of flaw conditions. The information in the vector diagram (Figure 4-10) illustrates this. Decreases of conductivity (e.g., cracks) and permeability could produce the same signal amplitude, and it would be difficult to differentiate between cracks and normal permeability changes in a part. However, the phase angle of a conductivity change is very different from a permeability change if the correct test frequency is chosen. Using phase detection techniques, it becomes a simple matter to detect the difference between permeability

variations and cracks. This also applies to determining the depth of a flaw, which is phase sensitive, or separating lift-off effects from flaw conditions. Phase sensitive detectors use a variety of techniques such as phase splitters, phase shifters, averaging, half-wave and full-wave detection, sampling, and subtractive and additive techniques. The presentation of the impedance plane on waveform display eddy current instrument; uses two-phase sensitive detectors to provide horizontal and vertical phase detection. This information is combined to produce a dot or point on the screen which represents the relative phase and amplitude of an eddy current signal. Some types of meter instruments utilize an adjustable phase control or phase gate to allow only signal detection at a particular phase angle of interest.

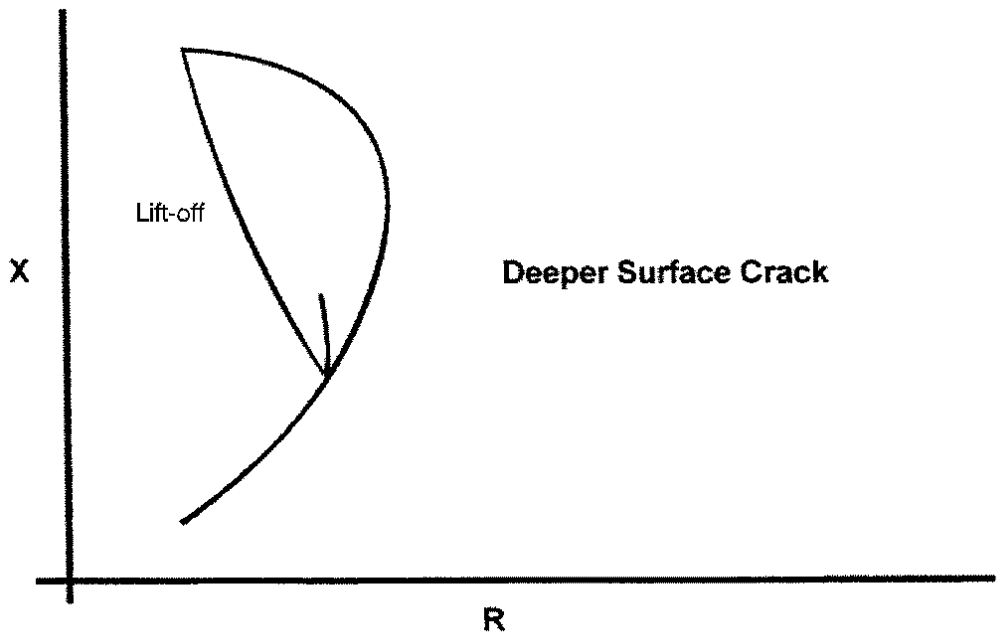
4.3.12.2 Cracks, Lift-Off, and Conductivity. The impedance changes due to surface cracks of different depths. The change for cracks will lie between the lift-off and conductivity. As the crack depth increases, the response moves farther from lift-off and closer to decreasing conductivity.

4.3.12.3 Crack Detection in Non-Ferromagnetic Materials. The amplitude of the response from a surface crack increases as the crack gets deeper. When the crack reaches three standard depths ([Paragraph 4.3.4.1](#)) it is interrupting essentially all of the eddy current flow and no increase in amplitude is seen as it gets still deeper. Besides an amplitude increase for deeper cracks, the phase angle of the crack indication changes. A shallow crack interrupts little of the eddy current flow, so the amplitude of its signal is small. Also, it is essentially a surface condition, so the direction (phase) of the signal response is very close to that of lift-off ([Figure 4-18](#)). A deeper crack interrupts more of the eddy current flow, so its signal has greater amplitude. It extends well below the surface, the direction (phase) of its signal is farther away from lift-off ([Figure 4-19](#)). The three standard depths crack has the largest amplitude response. It interrupts the eddy currents as far down in the metal as the test can sense, it looks like a change in the bulk property of lower conductivity, and the crack signal direction (phase) is along the conductivity curve ([Figure 4-20](#)).



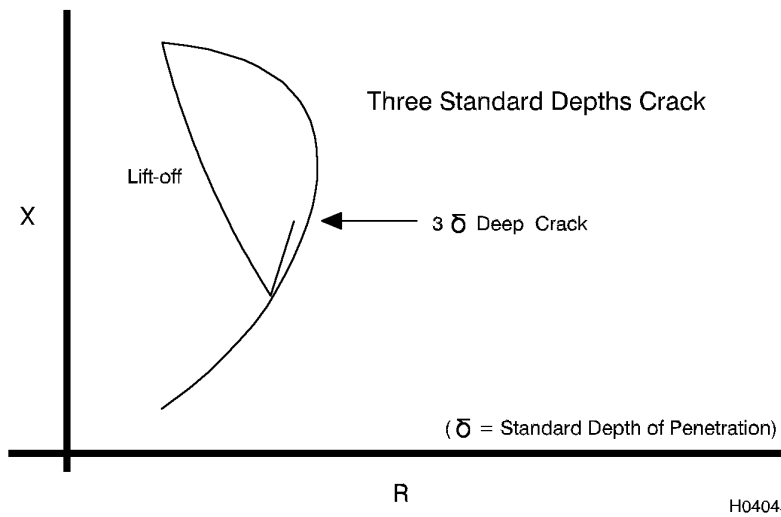
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Figure 4-18. Shallow Surface Crack



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Figure 4-19. Deeper Surface Crack



H0404504

Figure 4-20. Three Standard Depths of Penetration

4.3.12.3.1 Making the three standard depths crack deeper will not change the signal response because there will be no eddy current flow for it to interrupt. However, there will be a change in the signal response for a subsurface crack. First, eddy currents will flow over the top of the crack (at the surface), the subsurface crack will not block as much of the eddy current flow and the amplitude of the signal must decrease. Second, the crack is now farther away from the surface so its phase angle must still be further away from lift-off ([Figure 4-21](#)).

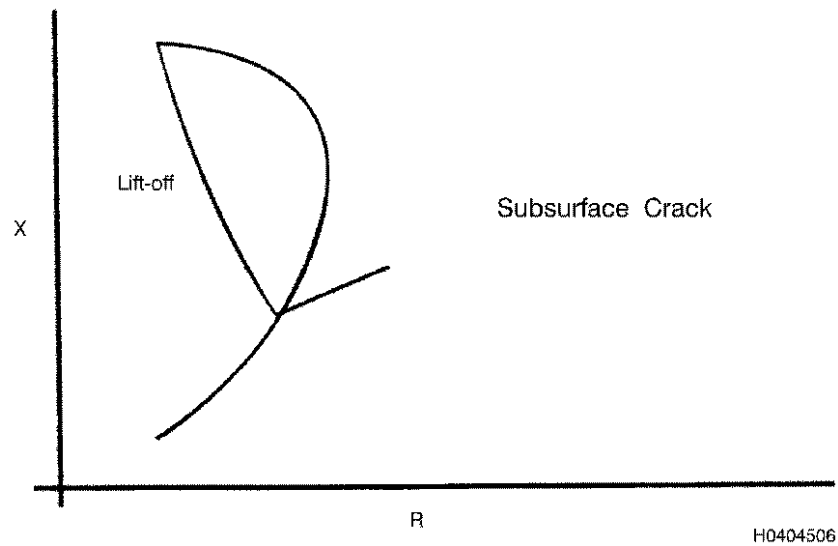


Figure 4-21. Subsurface Crack

4.3.12.3.2 Signal response decreases as the depth of the crack below the surface increases. As the subsurface defect gets further away from the surface, the signal amplitude gets smaller and the phase angle rotates clockwise, away from lift-off (Figure 4-22).

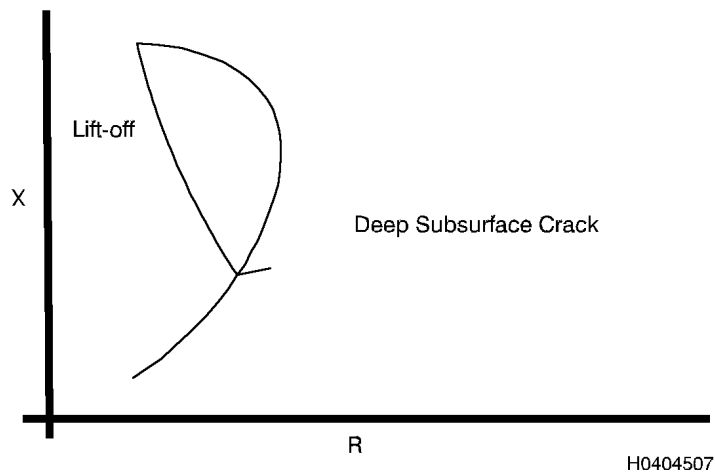


Figure 4-22. Deep Subsurface Crack

4.3.13 Phase Lag at Depth. A phase angle shift can occur and change the eddy current field time and travel distance. Changes at the surface of the part are seen immediately by the coil, while disturbances to the field at some depth in the part require some travel time to return to the surface where they are seen by the coil. Electrically, this is described as phase lag at depth, and the amount of phase lag is 1 radian (57°) per standard depth of penetration (Figure 4-23). This phase lag from the lift-off (surface) signal may be used to measure the depth of defects. The phase angle of a defect signal correlates to defect depth.

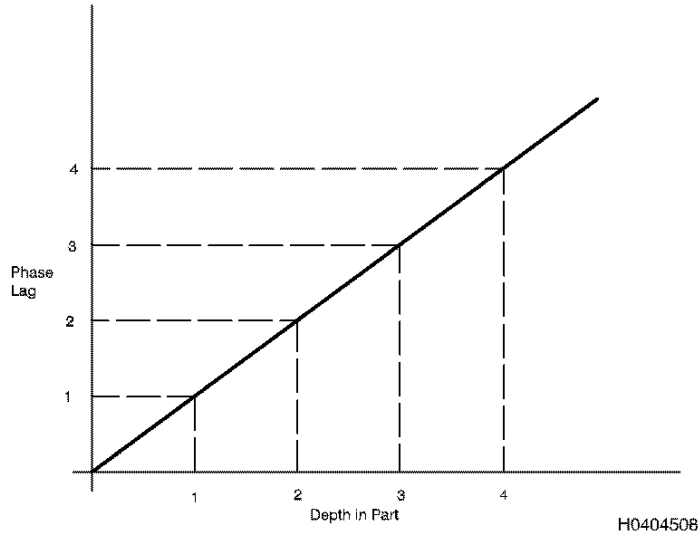
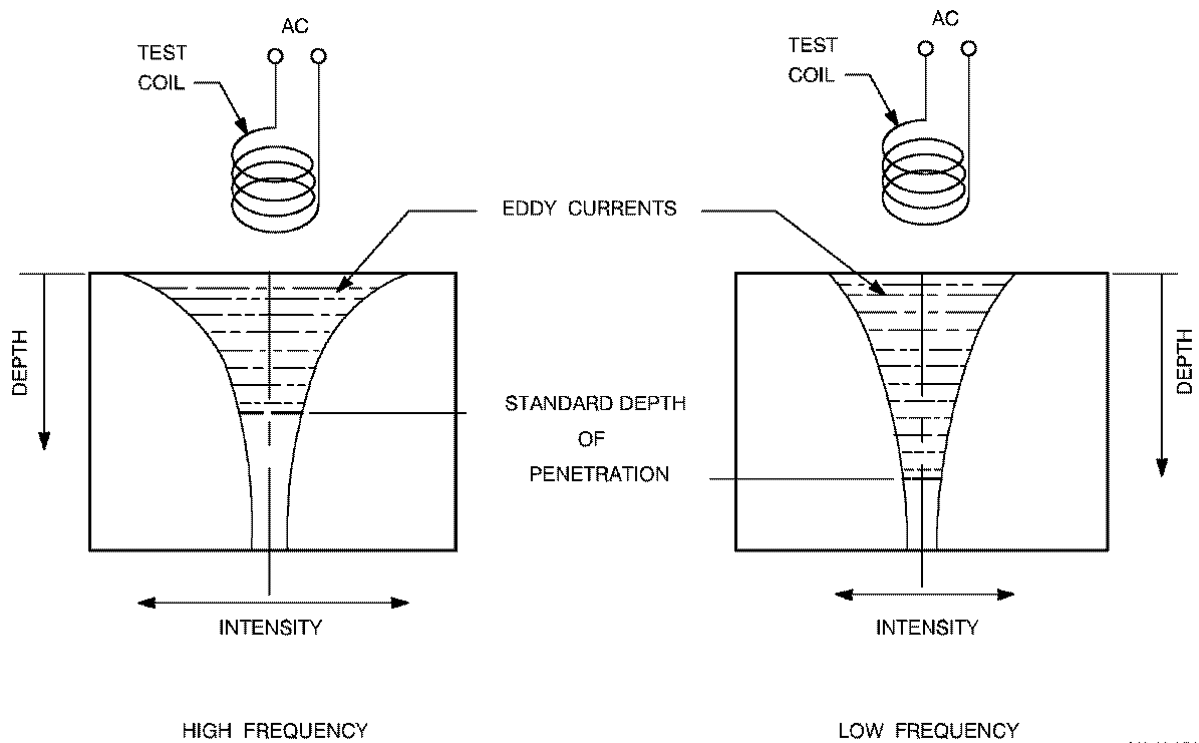


Figure 4-23. Phase Lag and Depth in Part

4.3.14 Effects of Inspection Conditions on Eddy Currents.

4.3.14.1 Frequency. The magnitude of the induced eddy currents in the part increases as the frequency of the inducing current increases. In turn, the higher intensity eddy currents generate a stronger opposing magnetic field, reducing the penetration of the primary field. Therefore, all other factors remaining constant, higher frequencies result in shallower depths of penetration as shown in [Figure 4-24](#).



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Figure 4-24. Relative Effect of Frequency on Depth of Penetration

4.3.14.2 **Conductivity and Frequency.** There is a relationship between conductivity and optimal inspection frequency. As an example, an eddy current inspection for cracks in aluminum alloy 7075-T6, with a conductivity of about 30% IACS uses a frequency of 200 kHz. To perform an inspection with comparable depth of penetration on a titanium alloy, TI 6Al-4V with a conductivity of about 1% IACS, a frequency of about 6 MHz would be required.

4.3.14.3 **Electromagnetic Coupling.** The interaction between the primary electromagnetic field generated by the coil and the inspection article is referred to as electromagnetic coupling. Because the field decreases in strength with increasing distance from the coil, resultant eddy currents at the surface of the part will also decrease in intensity. An electrical engineering term that could also be used is inductive coupling.

4.3.14.4 **Fill-Factor.** When an encircling coil is used to inspect a cylindrically shaped part, the degree of magnetic coupling is dependent upon the difference between the internal diameter of the coil and the external diameter of the part. This effect is termed fill-factor. For internal coils, electromagnetic (inductive) coupling is determined by the air gap between the external diameter of the coil and the internal diameter being inspected. Fill-factor is calculated using the basic formula, but in this case " d_i " is the inside diameter of the part and " D_o " is the outside diameter of the coil placed in the part ([Paragraph 4.8.3](#)).

4.3.14.5 **Coil Current.** With all other factors constant, an increase in current flowing through the coil results in a higher magnetic field strength.

4.3.14.6 **Temperature.** The temperature at which an inspection is performed affects both the electrical conductivity and the ferromagnetic properties of the inspection article. Electrical conductivity generally decreases with increasing temperature, and conversely increases with decreasing temperatures. The reduction at higher temperatures occurs because of the scattering of conduction electrons by atoms moving with increased thermal oscillations. Temperature effects on the ferromagnetic properties of a material are generally negligible with one exception. Above a specific temperature called the Curie temperature (about 1400°F or 760°C), ferromagnetic properties disappear. Because of the thermal effects on conductivity, increasing temperature of the inspection article slightly decreases the intensity of eddy currents at the surface of a part and slightly increases the depth of penetration. Temperature variations also affect the inductance of the coil. Remember, changes

in temperature affect ET results. Therefore, during inspections, time SHOULD be allowed for the test system and the test part to stabilize to the ambient temperature. An example test would be to see if part and standards feel the same to the bare hand.

4.3.14.7 Geometry. Geometric features such as edges, curved surfaces, changes in thickness, and non-conductive coatings (such as paint) on surfaces affect the distribution and strength of eddy currents. As a probe approaches an edge the eddy current response is known as edge effect and appears similar to a response from a crack. Similarly, curved surfaces and non-conductive coatings can vary the distance between the probe coil and the part. These changes are known as lift-off, and the consequent effects on the eddy current signal are called lift-off effects. Lift-off usually cannot be completely prevented; therefore compensating for some lift-off is part of the setup procedure. Part thickness variations can also produce an interfering response in some eddy current units when the thickness is in the range of the depth of penetration of the eddy current field.

4.3.14.8 Lift-Off. The effects of lift-off can be used to measure coating thickness. Changes in lift-off can be calibrated to allow measurements of nonconductive coating thickness. Fill-factor applies to parts passed through an encircling coil and, in a manner similar to lift-off, can be used to gauge some dimensions. As a test coil is moved away from a part (increasing lift-off) the coupling between test coil and inspection part is decreased. The magnitude of the impedance change for a specific change in an inspection variable is also decreased. For probe coils, the dotted lines connecting points representing the same material properties but with various amounts of lift-off have some curvature as shown in [Figure 4-17](#). The line A-B-C represents the increase lift-off for material one. Line D-E-F represents the increased lift-off for material two. The line from point A to point D represents the increase in conductivity of material two compared to material one at one lift-off value. Lift-off lines B-E and C-F are increasingly shorter, indicating a smaller change in the conductivity.

SECTION IV EDDY CURRENT EQUIPMENT

4.4 ET EQUIPMENT.

Most eddy current nondestructive test instruments for field use are portable AC or battery powered units. They are generally lightweight, less than 6 lbs., with batteries that provide up to 12 hours of operation. They can have a type of digital display such as liquid crystal display (LCD), or electroluminescent (EL) display. Some units have dual frequency operations with interchangeable display features. Newer units have state-of-the-art circuitry with advanced microprocessors. Frequency ranges of approximately 100 Hz to 6 MHz for detection of large and minute discontinuities. These units can be used to inspect first and second layer cracks, coating, plating thicknesses, and conductivity testing.

4.4.1 Components of an Eddy Current System. In its simplest form, an eddy current inspection system consists of the following components:

- An oscillator
- A coil assembly
- A bridge circuit
- Signal processing circuits
- An output display (readout/screen)

A block diagram of an inspection system is shown in [Figure 4-25](#) with the coil applied to a test part. Systems may be constructed for multiple purposes or for very specialized functions. In general, instruments designed for specific tasks, such as measuring coating thickness or electrical conductivity, are easier to calibrate and operate than general-purpose instruments but also are limited to their designed application.

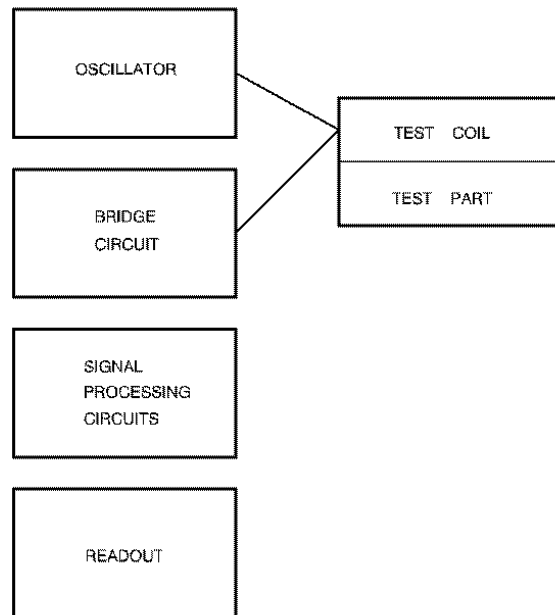
4.4.1.1 Oscillator. The oscillator provides an alternating current of one or more frequencies to the test coil. The frequency used is determined by the intent of the inspection and the material being inspected. Frequencies used for ET range from less than 100 Hz to greater than 6 MHz.

4.4.1.2 Coil Assembly (Probe). The coil assembly induces eddy currents into the part being inspected and detects changes in eddy current flow. For some applications, a single coil is used for both functions. More commonly, multiple coils are employed in an assembly. A common configuration has one coil inducing the eddy current flow and separate coils used as detectors. Another configuration uses one coil as both an inducer and a detector on the test part.

4.4.1.3 Bridge Circuit. The bridge circuit converts changes in eddy current magnitude and distribution into signals that are ultimately processed and displayed. A common mode of operation is to have the output of the bridge equal zero for a "good" or "non-flaw" condition. Presence of a flaw or an "other-than-good" condition results in an unbalance of the bridge, thus producing a relatively small signal. This signal becomes the input to subsequent circuits.

4.4.1.4 Signal Processing Circuits. The processing of the signal from the bridge circuit depends on the type of information to be displayed. Simple eddy current devices can be built that detect and amplify the signal or convert the signal into digital format (e.g., a conductivity value). More sophisticated systems can process the complex electromagnetic signal into amplitude and phase, and provide filtering to suppress unwanted signals. Details of the processes are discussed further in later sections.

4.4.1.5 Output Display. Eddy current test data can be presented in analog or digital format. Some common output devices are meter readout, a strip chart, an X-Y recorder plot, or digital display. Meters are suitable for performing specific types of tests requiring a measurement of signal amplitude only. Strip charts, X-Y recorders, and digital storage allow the signal amplitude to be displayed and correlated with some other parameter such as time or position. Eddy current instruments with a two-dimensional graphical display are used where both the eddy current signal amplitude and phase must be measured. These are the most common instruments available, and provide the inspector with the greatest capability to interpret results.



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Figure 4-25. Block Diagram of ET System

4.4.2 Eddy Current Subsystems. Eddy current systems generally consist of three subsystems. One is the probe or probe subsystem. Second is the eddy current instrument. The third is the accessory subsystem. Scanners and recorders are included with some subsystems and are considered to be accessories.

4.4.2.1 Probes (Coil Assemblies). Eddy current probes consist of one or more coils designed to induce eddy currents into a part being inspected and detect changes within the eddy current field. A fundamental consideration in selecting an eddy current probe is its intended use. A small diameter probe or narrow encircling coil will provide increased resolution of small defects. A larger probe or wider encircling coil will provide better averaging of bulk properties with a loss in sensitivity to small defects. Also the probe or coil must match the impedance range of the eddy current instrument with which it is to be used.

4.4.2.1.1 Probe Shielding. Probe shielding is used to prevent or reduce the interaction of the probe's magnetic field with nonrelevant features in close proximity of the probe. Shielding could be used to reduce edge effects when testing near dimensional transitions such as a step or an edge. Shielding could also be used to reduce the effects of conductive or magnetic fasteners in the region of testing. Eddy current probes are most often shielded using magnetic shielding or eddy current shielding.

4.4.2.1.1.1 Magnetically shielded probes have their coil surrounded by a ring of ferrite or other material with high permeability and low conductivity. The ferrite creates an area of low magnetic reluctance and the probe's magnetic field is concentrated in this area rather than spreading beyond the shielding. This concentrates the magnetic field into a tighter area around the coil.

4.4.2.1.1.2 Eddy current shielding uses a ring of highly conductive but nonmagnetic material, usually copper, to surround the coil. The portion of the coil's magnetic field that cuts across the shielding will generate eddy currents in the shielding material rather than in the nonrelevant features outside of the shielded area. The higher the frequency of the current used to drive the probe, the more effective the shielding will be due to the skin effect in the shielding material.

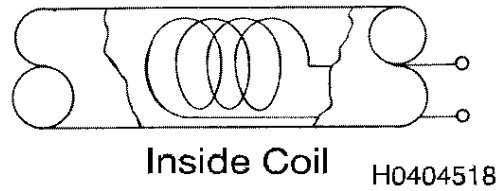
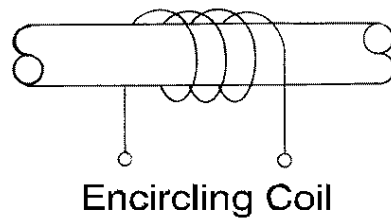
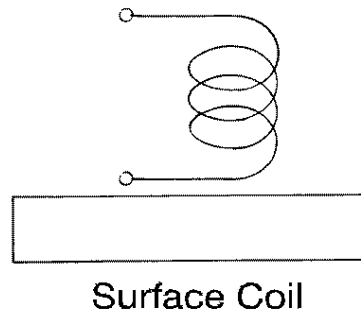
4.4.2.1.2 Classification of Probes. Eddy current probes and coils can be classified by mode of operation, application, or design.

4.4.2.1.2.1 Mode of Operation. There are three general modes of operation for eddy current coil assemblies; absolute, differential, or driver/receiver (also called reflection).

- a. The most common type of eddy current probe used in field applications is the absolute probe. Absolute probes consist of a single coil that is placed in contact with, or adjacent to, the part being inspected. Since any changes in the area interrogated by the coil produce a response, absolute probes can be used to measure specific materials properties such as electrical conductivity and magnetic permeability. They may have other discrete electrical elements such as capacitors included in the probe housing for matching to specific equipment requirements.
- b. Differential probes contain two or more coils and are intentionally designed to produce a response when changes are sensed by the active coil only. Consequently, if the differential probe has two coils mounted side by side, gradual changes in electrical conductivity or magnetic permeability would be sensed by two coils simultaneously and no response would occur. On the other hand, if an abrupt change in conductivity should occur, localized to where it can be sensed by only one coil at a time, then there would be a response. Normally, in both surface and bolt hole differential probes, two small sensing coils are wound side-by-side in the shape of two back-to-back capital D's. They are wired in series, with one wound clockwise and the other counterclockwise. This produces an indication from a crack that deflects first one way, then the opposite way, while producing little or no indication from conditions that affect both coils equally, like lift-off or conductivity change.
- c. Reflection probes can have a wide variety of configurations, but all have a driver coil wired separately from one or more receiver coils. A probe with one receiver coil is called "reflection-absolute", and a probe with two receiver coils is "reflection-differential". Reflection probes generally deliver better signal-to-noise levels, but are harder to make and therefore more expensive.
- d. A fourth type of probe, remote field, has two or more coils, with the driver coil being a distance from the receiver coil(s). Remote field eddy current probes are used for deep penetration into thicker structures.

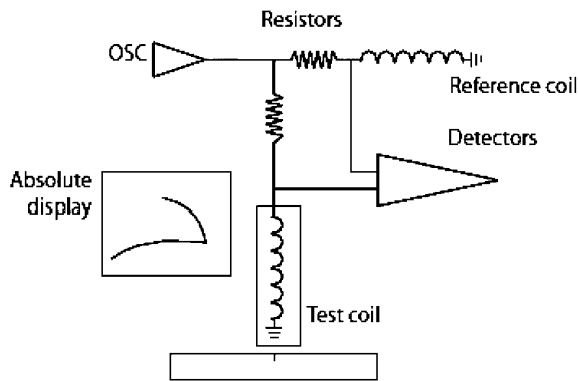
4.4.2.1.2.2 Method of Probe Application. Eddy current probes can also be classified by the method of application [Figure 4-26](#)). The most common application is the contact or surface probe used for flat or relatively flat surfaces of a part. Eddy current probes used to encircle a part are called encircling coils. Eddy current probes completely encircled by the part are called ID coils or bobbin coils. Through-transmission probes, which utilize a coil on each side of a part (a sheet of aluminum for instance) is another method of application. All of these probe applications can be operated in absolute or differential modes ([Figure 4-27](#)). Eddy current probes can also be classed according to the shape or some other prominent feature of the probe. Very thin probes are called pencil probes. Probes with special electromagnetic shielding are called shielded or focused probes. Probes used in rivet or bolt holes are called bolt hole probes. Certain types of probes with shaped ferrite cores may be referred to as E-core, U-core, and pot or cup core probes.

4.4.2.1.2.3 Probe Design Considerations and Limitations. Eddy current probes have several conflicting requirements. First, they must be a reasonable match to the electrical impedance requirements of the instrument to which they are connected. The closer the impedance match, the higher the signal-to-noise ratio. Also, the coils need to be designed for the flaw size to be detected. Smaller flaws require smaller coils. Most eddy current testing in the field is accomplished with surface probes. The surface probe is used on plates, sheets, irregularly shaped parts, and in holes. The extent of the area to be tested by the probe is controlled by the coil diameter and by the presence of coil shielding. When the area to be scanned is large, pancake-type surface coils or overlapping multi-coil probes can be used to reduce the time required to inspect the part. When small flaws must be detected, coils, as small as 1/32 inch in diameter, can be used to examine limited areas.

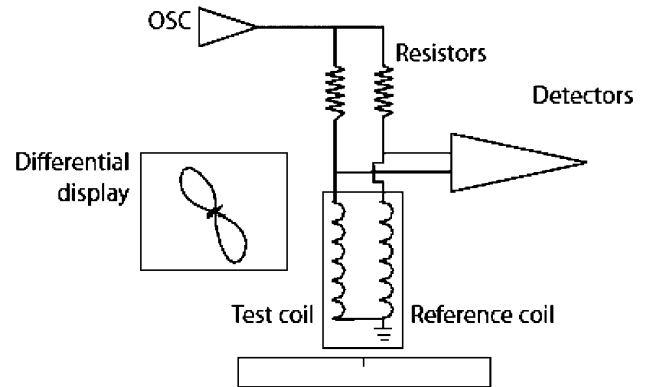


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Figure 4-26. Basic Coil Configurations



Absolute Mode



Differential Mode

H0404519

Figure 4-27. Example of Absolute and Differential Mode

4.4.2.1.2.4 Use and Limitations of ID and Encircling Coils. An inside diameter (ID) coil may be used on tubes, pipes, or other cylindrical parts where the geometry is regular and the interior is accessible. The ID coil should nearly fill the part opening in order to provide a high fill-factor for maximum test sensitivity. The use of ID coils can be restricted by bends or non-uniform diameters. Encircling coils are used primarily for inspecting rods, tubes, cylinders, or wire in manufacturing applications. With both encircling and inside coils, the entire circumference of the specimen is evaluated at one time. Consequently, while the axial location of defects (along the part length) can be determined, circumferential location (around the part) cannot be defined.

4.4.3 Functions of the Eddy Current Instrument. The eddy current test instrument performs three basic functions. First, it generates the alternating current that induces the eddy current flow in the part to be inspected. Second, it processes the responses to the induced eddy current flow. Third, it displays the responses in a manner to aid interpretation.

- a. Current Generators. The current generator is usually a variable frequency oscillator operated at a single frequency for any given inspection. Most instruments have the capability of operating at frequencies from 100Hz to 6 MHz. Newer instruments have the ability to provide multiple frequencies to the test coil(s), either sequentially or simultaneously.
- b. Processing. The processing function of the eddy current instrument includes a number of sub-functions. Most instruments include some form of a balancing or compensating circuit which is adjusted to provide essentially a zero output for non-flaw conditions. The signal from the bridge circuit is amplified before proceeding to the detector and/or analysis circuitry. Signals can be analyzed for their amplitude and phase. The output from the analysis circuits may be further filtered to assist interpretation before display.
- c. Display Methods. The primary display method of most eddy current devices is either one dimensional, such as a meter, or two-dimensional, such as an LCD screen. The outputs can also be transferred to X-Y recorders, strip chart recorders, magnetic storage media or even computers to both generate inspection records as well as aid in the analysis of the eddy current signals.

4.4.3.1 General Requirements. Eddy current instrumentation is the core of an eddy current system, whether the system is a simple instrument/coil combination or a fully automated scanning inspection station. To assure reliable operation, the instrumentation must have the capabilities described below:

- a. Sensitivity. A term that refers to the instruments capability to find the most difficult to locate flaws; with reference to the size and type that need to be detected.

- b. Low Noise. The noise should be low enough so the signal from the smallest flaw to be found (or smallest calibration flaw) is at least three times the noise level of the instrumentation.
- c. Response Time. The response time of the circuitry must be fast enough to process and display signals at the required scanning rate.
- d. Selectivity. The instrumentation should be immune to external sources of electromagnetic interference.
- e. Stability. The instrumentation display should remain frequency drift-free, during the required testing period.
- f. Ruggedness. The instrumentation must be capable of operating in the test environment. This may include a variety of environmental extremes of temperature, humidity, dust, and vibration.

4.4.3.2 Specific Instrumentation Requirements. Choice of an eddy current test instrument must take into account the type of flaw to be detected, the permeability of the material (nonferromagnetic or ferromagnetic), type of probe to be used, display method (meter, digital display, recorders, etc.), test frequency, and signal processing requirements, portability, if needed, and any accessories to be used.

4.4.3.3 Instrumentation Components. In general, most eddy current instruments consist of an oscillator, a bridge circuit or similar null balancing system, and a variety of other circuits for processing and display of the eddy current signal. Units will vary depending upon the complexity of the instrumentation and the requirements of the test.

4.4.3.4 Variable Frequency Oscillator. A basic eddy current instrument, while operating at a single frequency during a particular test, usually has an operating frequency range that is adjustable to meet a large variation of inspection situations. Low frequencies increase depth of penetration and consequently would be used for subsurface flaw detection in high conductivity materials. Higher frequencies limit depth of penetration and thus are used for low conductivity materials as well as for detecting smaller flaws. Some instruments also incorporate a fine adjustment of frequency as a mechanism for suppressing lift-off. These instruments incorporate the probe coil in parallel with a capacitor as one leg of a bridge. The coil/capacitor combination is resonant near the intended operating frequency. The frequency selected for operation causes a meter deflection off-resonant enough to where lift-off causes less of an impedance change than caused by a defect and the impedance change for increasing lift-off is opposite to that for a defect.

4.4.3.5 Bridge Circuit. A basic bridge circuit is shown in [Figure 4-28](#). In this example, a voltage is applied at points E1 and E2 to the bridge containing impedances Z1, Z2, Z3, and Z4. Z1 and Z4 are fixed impedances of the same value; Z3 is an adjustable impedance; and Z2 the unknown or test probe impedance. Initially, Z3 is adjusted so that no current flows through the amplifier. This means the voltage at points A and B is the same and the bridge is said to be balanced or nulled. Any change in impedance of Z2, the test probe impedance, will result in a current change through the leg of the bridge and consequently a change in the voltage at point B. A current will then flow through the amplifier, since a voltage or potential difference exists between points A and B. The bridge is now said to be unbalanced. The bridge can again be balanced by adjustment of Z3 and the change in the test probe impedance, Z2, may be determined by measuring the change in Z3 required to rebalance the bridge. The bridge circuit in an eddy current test instrument is termed an impedance bridge since the circuit contains both resistive and reactive elements. Impedance Z2 in [Figure 4-28](#) would consist of the eddy current test coil. Other reactive elements, inductors, and capacitors may be included in the impedance bridge depending upon the specific design and function. However, the basic principle is that a change in impedance of the test coil results in an imbalance of the bridge circuit. The output (imbalance) from the bridge circuit can be amplified, processed and displayed.

4.4.3.6 Amplification Circuits. The imbalance in the bridge circuit is due to an impedance change at the test probe. It results in a change in signal amplitude, signal phase or both. These signal changes must be amplified, detected or demodulated, and processed for presentation on the output device (meter, scope, or recorder, etc.). The flaw signal may be only several micro volts in amplitude and may require amplification of one thousand to one million times for further processing and display. The frequency content of the flaw signal can range from very low (essentially DC) to the maximum operating frequency of the eddy current instrument. This defines the distortion-free frequency response of the amplifier. The amplifier must also be very stable with very little drift in order to maintain the required sensitivity and calibration throughout the duration of the test.

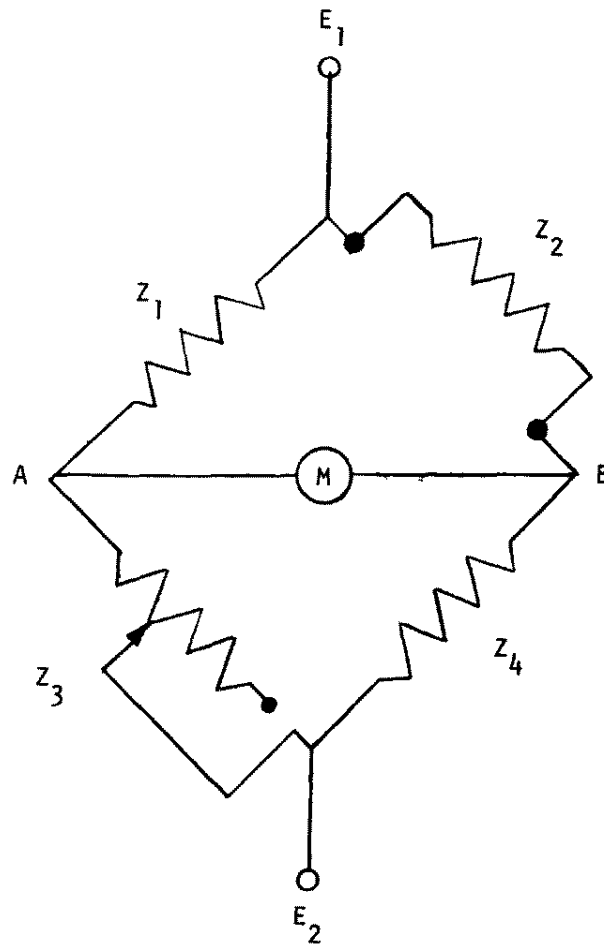


Figure 4-28. Basic Bridge Circuit

4.4.3.7 **Presentations and Displays.** The output from an eddy current instrument may be read on a meter, impedance plane display, or recorder depending on the type of information required from the test. An analog (pointer) type meter is the simplest type of output indicator. An output consisting of amplitude and phase is called an impedance plane display, and can be displayed on a LCD or EL display. LCD/EL display's show the eddy current signal, menu sidebar, status bar, other indicators, and full screen text.

4.4.3.7.1 **Meters.** Older portable metal flaw and conductivity detectors used a meter that essentially indicated the degree of bridge imbalance in terms of amplitude. Depending upon the instrument circuitry, phase differences could also be displayed on a meter. These eddy current instruments contain built-in output meters specifically designed or selected for use with the particular circuitry involved. If used, these meters SHALL have a speed of response sufficient to detect the discontinuities of interest at the highest expected scan speed. However, the meter should be sufficiently damped so "noise" indications do not confuse the inspector, but not damped to the point information of interest may be suppressed. Optimum meter response is a balance between speed of response and damping.

4.4.3.7.2 **Digital Display.** Most eddy current units provide waveform output on a two-dimensional display of small, square spots called pixels. Light is generated on such a screen by applying a small voltage to the individual pixels. A wave form is created by energizing the pixels needed to shape the appropriate waveform. Since the persistency of a digital display is controlled by an applied voltage rather than by electron impact with a phosphor coating, the persistence can be controlled by the operator. In general, the lighted pixel will remain lighted until the operator 'erases' them by turning off the voltage to the pixels.

4.4.3.7.2.1 Linear Time Base Display (Sweep). Eddy current test equipment often has the ability to use a linear time base display. The display's vertical signal, is received from the test coil and the display's horizontal signal (e.g., time), is received from a timing voltage. The timing voltage is adjusted to the frequency or period of the generator and provides a linear horizontal sweep of the vertical input voltage. A change in reactance of the test coil result, in a phase change of the voltage across one of the bridge circuit arms (vertical signal). This phase change is evidenced by a shifting (along the horizontal base-line) of the waveform. During operation, the timing or sweep voltage is used to adjust the display to show the desired number of waveform cycles (usually one). Generally, control is also included to control the horizontal position of the waveform on the screen.

4.4.3.7.2.2 Impedance Plane Eddy Current Test Equipment. The use of impedance plane analysis equipment greatly increases the flaw analysis capability of the eddy current inspection process. Some eddy current equipment uses the vector point display technique of displaying information on a screen. Signal phase and amplitude are directly presented for analysis of the eddy current information. The display consists of a point of light rather than a waveform. Changes in the test article relative to the reference standard will cause the point of light to move. Movements of the point of light can be analyzed to determine which test variable (conductivity permeability or dimension) causes the change.

4.4.4 Digital Equipment. The use of digital test equipment, along with digital computers to process and analyze data, has provided significant reduction in noise levels. This has effectively increased the sensitivity of the flaw detection process.

4.4.5 Recorders. Recorders are used primarily in testing where the test coil or the test parts are moving relative to one another. Many newer applications using a test fixture and a mechanical scanner to move an eddy current probe across a specific area of a part can use a recorder to map the flaw indications. A recorder for eddy current applications may be any of several types. However, the strip chart recorder is probably the most common. Newer eddy current instruments provide means of storing information on digital media. This is particularly useful where down time is important, since testing can be accomplished as rapidly as possible, and the information stored on tape for later analysis. When selecting a recorder for use with a particular eddy current instrument, several factors must be considered:

- Impedance match between recorder and instrument
- Frequency response of recorder
- Recorder sensitivity (voltage range)
- Response time

4.4.6 Mechanical Scanners. Increased use of mechanical scanners to control probe movement has improved the detection capability of many test methods. Repeatability of testing is also enhanced by mechanical scanning. A mechanical scanner can provide testing of difficult to reach areas of parts. Remote video cameras can also be incorporated with a mechanical scanner to provide visual coverage during the testing of inaccessible areas.

4.4.7 Fixtures and Guides. The single most important requirement for detecting a small crack is that the coil pass over the crack. Specially shaped probes, fixtures and guides can help ensure this happens. Probe guides increase eddy current inspection detectability and should be used whenever necessary. The simplest eddy current scanning guide is a section of thin flexible plastic cut to conform to the inspection area with allowance for probe positioning. Such a guide can be easily prepared from used X-ray film. The flexibility permits fitting of the guide to compound curvatures. It is necessary that the edge used to guide the probe be smooth to allow steady movement at a constant distance from the edge of the opening. The guide can either be held in place or taped in the required position. Another type of probe guide which can be used for small openings, including holes with bushings, consists of a circular insert which fits into the hole and has a larger diameter at one end to provide the required offset distance from the edge of the hole. Probe guides SHOULD be constructed to provide the required offset from the edge for a specified type of probe and SHOULD NOT interfere with movement of the probe.

4.4.8 Special Processes. A wide variety of electronic techniques have been developed for particular inspection problems in eddy current testing. The circuits used depend upon the type of output, the type of flaw to be detected, or when a particular test variable (such as lift-off) must be suppressed in order to detect other conditions.

4.4.8.1 Amplitude Detection. The most common type of detection meter on eddy current instruments is one which needs to detect signal amplitude changes without the use of phase information. In this case, amplitude detection with a simple diode type detector can be used. The diode rectifies the bridge output to produce a variable amplitude direct current signal.

4.4.8.2 Multi-Frequency Eddy Current. Multi-frequency eddy current can be used where several material properties are changing at the same time, such as when it is necessary to discriminate a crack from geometric changes in a complex part. To be effective, each condition to be suppressed must produce significant impedance changes for one frequency and less significant changes for the other frequencies used in the inspection. An example would be using a dual frequency inspection for subsurface corrosion while compensating for lift-off. A low frequency would be selected that would allow sufficient penetration to detect the corrosion. Lift-off responses would also be present from this frequency. Using a higher frequency would respond to lift-off but, not have sufficient penetration to respond to the corrosion. The analysis of these signals can become extremely complex. At present, most multi-frequency testing is limited to dual frequency testing.

4.4.8.3 Pulsed Eddy Current Techniques. The pulsed eddy current technique is a non-continuous wave test technique, and also has multi-frequency characteristics. The width of the pulse establishes the lower frequency limit while the sharpness of the pulse corners establishes the upper frequency limit. Conventional multi-frequency systems usually use two or three frequencies. Additional frequencies require very complex multiplex mixing systems to analyze the information from the test. A variety of experimental techniques have used the multi-frequency characteristics of a short electrical pulse to achieve the same type of results as the multi-frequency test technique. In principle, this technique is advantageous in that it requires simpler electronics to process the data. It can potentially generate higher frequencies than fixed frequency systems. This would allow testing of thinner materials and materials with very low electrical conductivity (high resistivity). The eddy current pulse can also be a very short, high voltage pulse that can be used to momentarily produce magnetic saturation in a ferromagnetic part. This will allow detection of subsurface flaws in ferromagnetic materials.

4.4.8.4 Metal Thickness Measurements. A wide range of thicknesses can be measured with low frequency eddy current test equipment.

4.4.8.5 Low Frequency Eddy Current. Low frequency eddy current means the inspection requires frequencies below 50 kHz. Improved equipment and data processing techniques now allow the use of test frequencies as low as 55 Hz. Along with impedance plane equipment to measure signal phase, this has provided a means for testing multilayer thick materials. Detection of deep subsurface cracks, cracking in intermediate layers of material, and corrosion on the backside of a material is possible.

4.4.8.6 Dual Frequency Testing. This is a basic version of multi-frequency testing that can be used to filter out one undesired condition. If only two frequencies are used, one frequency channel can operate in the differential probe mode and the other frequency channel can operate in the absolute mode. With this setup, the differential mode can be used to detect discrete indications such as small cracks and holes. The absolute mode can be used simultaneously to record wall thickness or other dimensional changes in the test part.

4.4.9 Electromagnetic Techniques Closely Related to Eddy Current. Although not part of the ET method as currently defined, the following are more closely related to ET than to any other basic NDT method.

4.4.9.1 Barkhausen Noise Testing of Ferromagnetic Materials. Abnormal stresses induced by shot peening, other cold working processes, and grinding burns affect the structural properties of a material, and can lead to flaw growth and part failure. In ferromagnetic materials, these processes affect the ease with which the magnetic domains in the surface of the material can be moved. In un-magnetized ferromagnetic material, the magnetic domains are randomly oriented. If the material is subjected to a magnetic field, the magnetic domains tend to align themselves in the direction of the magnetic field. When the domains move to align themselves, electrical pulses are generated during the domain movement, this is called Barkhausen noise. This electrical noise can be detected and measured by Hall Effect sensors. If the material is free of abnormal stresses, the domains are relatively free to move and little Barkhausen noise is generated. Areas of tensile stress parallel to the applied magnetic field cause an increase in Barkhausen noise. Examples of applications of this test method are ferromagnetic engine components and landing gear. Barkhausen noise measurements are also used to detect the quality of drilling and reaming of holes in ferromagnetic material

4.4.9.2 Magneto-Optic Imaging (MOI). Magneto-optic imaging depends on the ability of certain materials to rotate the plane of polarization of light in the presence of a magnetic field. This Faraday Effect is used to detect disturbances in the magnetic field produced by passing an alternating current in a thin planar foil of doped yttrium iron garnet. When the foil is placed near the surface of a metallic test object, eddy currents are produced which modify the magnetic field in the foil. When defects or other material discontinuities, such as rivets or holes, divert the otherwise uniform flow of electric current near the surface of the test piece, magnetic fields perpendicular to the surface of the test piece are produced which can be imaged in real time by an appropriately designed optical system. Since the system provides optical information, the results can be videotaped for analysis and permanent documentation.

4.4.10 Application of Advanced Techniques. Several of the advanced techniques and processes discussed above do not have fully developed and recognized test procedures, process controls, and qualification procedures. Specific application of ALL of these processes and techniques SHALL be in accordance with approved procedures and engineering approval.

SECTION V APPLICATION OF ET

4.5 GENERAL.

All inspections for cracks or other in-service flaws SHOULD be considered critical. Each inspection on every aircraft or weapon system should be approached with utmost care and concentration. Always setup your eddy current instrument in accordance with the established procedures. Be sure to check your setup several times during the inspection to ensure your equipment is responding properly. Take time to ensure you have carefully scanned the entire area of inspection, double checking your scans if necessary. The inspection you perform may be the last line of defense against a possible failure due to crack growth. Not finding a defect in an area during a previous inspection, does not discount the odds of it presenting itself in the future. Approach each inspection as if there were a known flaw in the area you are inspecting.

4.5.1 Null Point. The null point is the location on an impedance plane at which the eddy current instrument is nulled or "zeroed." If nulled correctly on a defect-free material, the instrument will place the signal (dot) on a specific point on the display, and any changes in the material, such as a crack, will cause the signal (dot) to reflect an electrical impedance change on the display.

4.5.2 Parameters. There are a large number of parameters that can be set on an eddy current instrument. However, the parameters most often adjusted by technicians are frequency, gain, phase angle, sensitivity and filters.

4.5.2.1 Frequency. The only freely adjustable parameter on modern instruments that affects the eddy currents is frequency. The rest of the parameters are there only to enhance the visibility of the signal response on the instrument. The lower the frequency, the deeper the field goes into the material and therefore the increased depth at which eddy currents flow. However, the field not only goes deeper, but it also spreads out, i.e. it "dilutes", resulting in less sensitivity to small variations (see [Figure 4-29](#)).

NOTE

The "spread" of the eddy currents depends on the conductivity of the material and the instrument drive frequency.

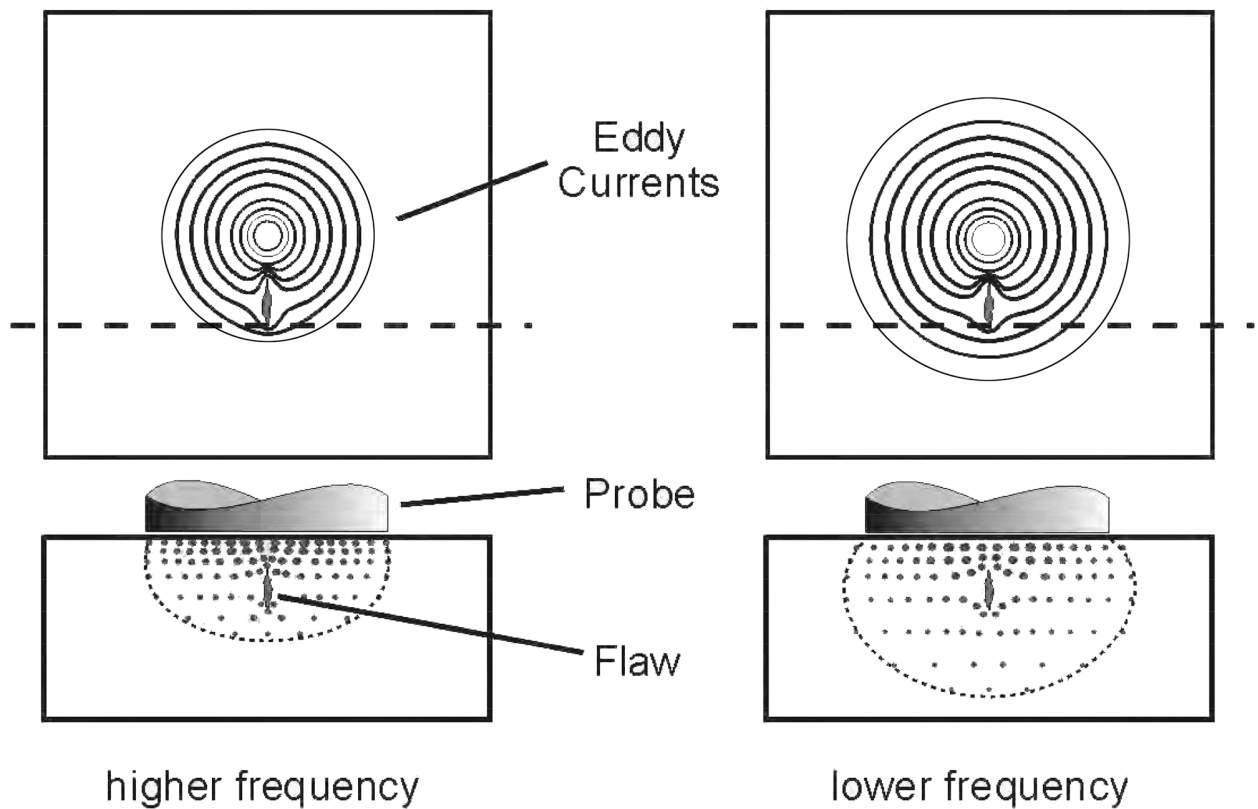
4.5.2.1.1 Frequency does not affect the strength of the eddy currents, just the "spread". Some instruments may allow adjustment to the drive voltage going through the generating coil, which in turn affects the strength of the eddy currents, resulting in higher flaw detection sensitivities. This is separate from frequency adjustment.

4.5.2.2 Gain. Gain can be increased to get a larger signal response (i.e. to make a small signal more visible) or decreased to lower the signal response on the instrument display. However, increases in gain will increase the "noise" on the instrument display. Noise can be caused by a variety of factors: the electronics of the instrument (not as likely in modern instruments), material noise resulting from grain-structure of the material, material noise caused by mechanically altering the surface of the material under test, etc.

4.5.2.2.1 Some instruments feature H-Gain (X-Spread) or V-Gain (Y-Spread) along with regular gain. These two gains allow the operator to independently increase or decrease the signal in the vertical or horizontal direction, and are very useful for helping to distinguish noise signals from flaw responses.

4.5.2.3 Phase Angle. May also be known as "rotation," or "rotation angle." Unrelated to the true phase of the eddy currents, it is a setting that allows the user to rotate the signal responses on the instrument screen. It may be used to orient the signal response from lifting the probe off the material ("lift-off" signal, when using an absolute probe). This aids the user in distinguishing between "lift-off" and a signal likely caused by a flaw.

4.5.2.4 Sensitivity. (not available on all instruments) a parameter that allows for "magnification" of the instrument display. It acts like the zoom-feature of the camera; it does not improve the "image," it only makes it larger or smaller. It is used to set the scale of the grid shown on the display. A common setting is 1 Volt per scale-division. This means that a signal that is 2 scale-divisions long has a voltage of 2 Volts. This measure is used to classify signals as acceptable or rejectable.

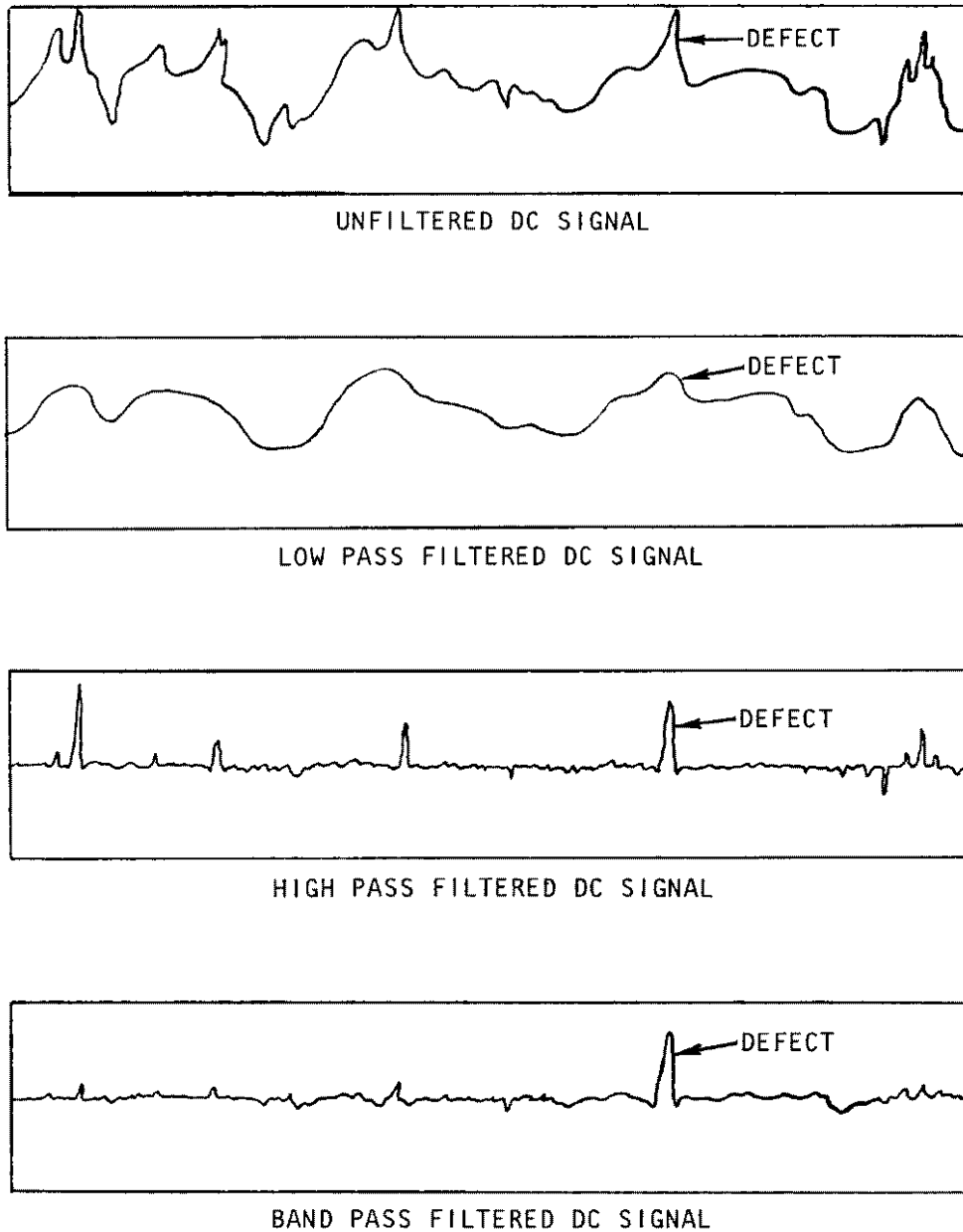


USAF/UniWest Image

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Figure 4-29. Illustration of Frequency and Eddy Current Distribution

4.5.2.5 Filters. Used to filter out unwanted signals and improve the signal-to-noise ratio as illustrated in [Figure 4-30](#). Three types of filters can be used: high-pass, low-pass, and band-pass. A high-pass filter (HPF) removes low frequency signals and lets high frequencies pass, and is useful to eliminate the effect of gradual variations in conductivity or dimensions on the eddy current response. A low-pass filter (LPF) removes high frequency signals and lets low frequency signals pass, and is useful in reducing effects of electronic noise and high frequency response from harmonic frequencies related to variations in magnetic permeability. Band-pass filters combine low and high pass filters to allow a response over a specific range of frequencies and suppress frequencies above and below this range.



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Figure 4-30. Illustration of the Effects of Different Filters on the Eddy Current Signal

4.5.3 **Modulation Analysis.** A technique useful in separating signals of interest from other signals relies on an analysis of signals as a function of time. A good example of this is using a sweep display or a strip chart where the amplitude of the signal appears on the vertical scale and the times at which the signal appears and disappears is monitored on the horizontal.

4.5.3.1 An example of modulation analysis is when an impedance plane instrument display is used in the sweep mode during a rotating bolt-hole inspection. In this technique, the equipment is typically set so each trace across the sweep represents one rotation in the hole. The clock position of an indication in the hole can be determined by its location across the sweep. Of more importance is the width of the indication or how long it deviates from the baseline. In this example how long the indication is detected (width) is used to identify whether or not it is due to a variable of interest. For example, out

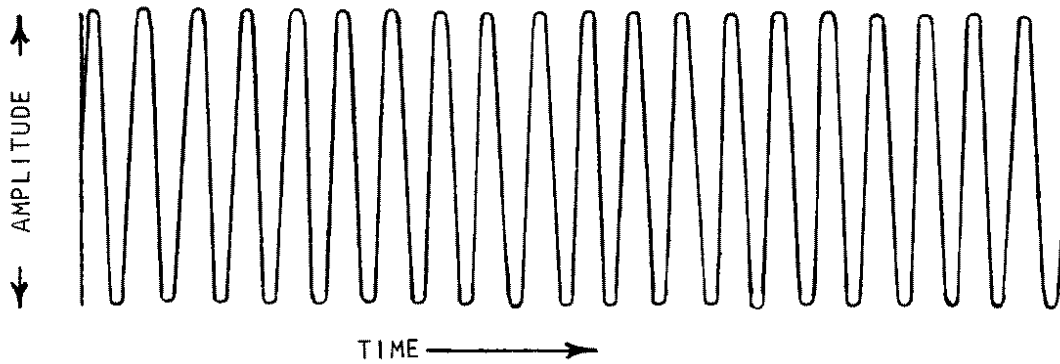
of roundness in a bolt hole will produce an indication that lasts a long period, while a crack is very narrow and produces an indication that lasts a short period. Both indications may have the same amplitude, but perhaps only the crack is of interest. An electronic filter can be used to suppress long lasting signals (low frequency) leaving only the crack indication (high frequency) on the display for the inspector to view.

NOTE

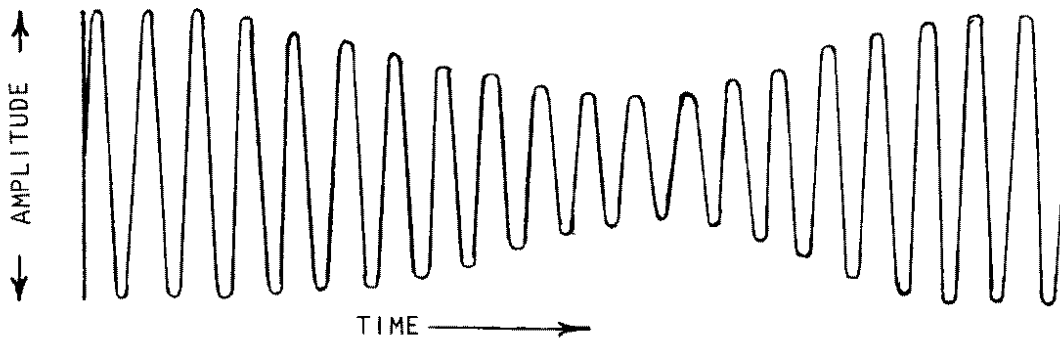
Regarding modulation analysis, it is important to understand the terms high and low frequency refer to how long the indication lasts, not the frequency of the alternating current in the coil.

4.5.3.2 The frequency of an indication is the reciprocal of the period that it lasts, or put another way: how many such events (cycles) could occur in 1-second. For example, suppose the indication of the out of round hole discussed in [Paragraph 4.5.3.1](#) lasts for 0.1-seconds across the sweep, and the indication of the crack lasts for 0.01-seconds across the sweep. The frequency "f" of the out-of-round signal would be $1/0.1$ or 10 cycles/sec (Hz), and that of the crack would be $1/0.01$ or 100 cycles/sec (Hz). A high pass filter could be set at 50 Hz to suppress signals under 50 Hz and allow signals over 50Hz to be displayed. Because there can also be signals that have a higher frequency than the variable of interest, a low-pass filter may also be used to suppress high frequency noise. This filter might be set at 200 Hz for the above example. Used together the high and low- pass filters form what is called a band pass filter, meaning only signals having a frequency over a specific range are displayed. In the above example, signals above 200 Hz are suppressed by the low-pass filter, and signals below 50 Hz are suppressed by the high-pass filter. In order to pass through both filters, the signal must be between 50 and 200 Hz, or last from 0.005 to 0.02 seconds.

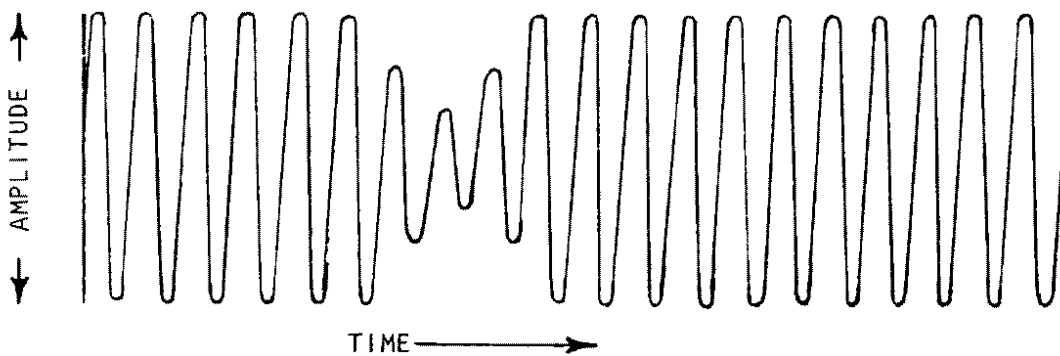
4.5.4 Frequency Response. Frequency response analysis is the most common form of modulation analysis. During eddy current testing, the impedance of the test coil remains constant provided there is no change in inspection conditions or material properties. When variations in impedance do occur, the rates of change in the impedance and resultant eddy current signal are proportional to the rates at which material properties are changing and the scanning speed. Consequently, a small crack would provide a rapid change in impedance during scanning and a corresponding high frequency eddy current signal. These signals can be viewed on a video display or a strip chart recorder as a function of time. The effect on amplitude, while encountering different kinds of material variations, and scanning at a constant speed is shown in [Figure 4-31](#). A fast signal change is often a good indicator of a small flaw or an abrupt change in material characteristics. A slow signal change usually indicates a gradual change in dimensions, lift-off, or some other property.



NO CHANGE IN INSPECTION MATERIAL



SLOW CHANGE IN INSPECTION MATERIAL



RAPID CHANGE IN INSPECTION MATERIAL

H0404535

Figure 4-31. Effect of Material Variables on Magnitude of Alternating Current in Test Coil With Constant Scanning Speed

4.5.5 Inspection of Fastener Holes.

4.5.5.1 Cracks in Fastener Hole Walls. A common application of eddy current inspection in aircraft structures is the detection of cracks in fastener holes, or walls. These cracks are usually generated by fatigue, stress corrosion, or a combination of fatigue and corrosion. The progress of these cracks is often slow in the initial stage, where early detection can prevent possible catastrophic failure.

4.5.5.1.1 Fatigue Cracks. Fatigue cracks are usually caused by repeated cyclic loading of a structure at lower stress levels than required for visible deformation. Because stress is concentrated at areas of localized weakness, such as holes, fatigue cracks often initiate at such points. The cracks usually propagate normal to the direction of the maximum applied tensile stress. The following describe two types of fatigue:

- a. High Cycle Fatigue (HCF). HCF usually means the stress applied is low compared to the ultimate tensile strength of the material but subjected to a very high number of cycles (examples: Vibration or air turbulence stresses).
- b. Low Cycle Fatigue (LCF). LCF usually means the stress applied is high compared to the ultimate tensile strength of the material but subjected to a very low number of cycles (examples: take-off and landing stresses).

4.5.5.1.2 Stress Corrosion Cracks. Stress corrosion cracks occur under the combined influence of a tensile stress and a corrosive environment on a material susceptible to stress corrosion cracking. The tensile stress may result from either an applied stress or a residual stress. Moisture in the air combined with a sufficiently corrosive environment may create stress corrosion cracking in some instances. In addition, a combination of cyclic fatigue in the presence of corrosion cracks can cause rapid growth of cracks.

4.5.5.1.3 Hole Wall Finish and Dimensions. The hole wall finish and dimensions influence both the occurrence and the detectability of cracks in fastener holes. Hole wall damage such as scratches, chatter, and grooves created during manufacturing can create additional stress concentrations at the hole wall and provide preferred sites for crack initiation. Loose fitting bolts caused by oversize or out-of-round holes allow movement in the area of the hole and allow fatigue action. These same conditions can influence the reliability of inspection. During inspection, severe damage to the hole wall results in eddy current indications that may not be separable from crack indications. Excessive lift-off from out-of-round conditions can also mask indications from cracks. All of these conditions can be created during manufacturing processes on the hole or as a result of fatigue action during service and from bolt removal.

4.5.5.1.4 Edge Effects. Many cracks in fastener holes occur at or near the edge of the hole. Adjoining structures, non-uniform countersink and deburring radii, and damage at the hole edges increase the background noise and decrease the signal-to-noise ratio. This leads to a general loss of detection of cracks at the edge of holes. Further effects on crack detectability result from the presence of other metals adjacent to the hole edge. Countersunk surfaces also limit ET by manual techniques adjacent to hole edges.

4.5.5.2 Bolt Hole Preparation. Holes in mating surfaces must be realigned prior to ET or drilled to a larger diameter, which is concentric through the mating parts. Prior to performing bolt-hole inspection, all foreign material must be removed from the hole. Foreign material can include sealant, lubricants, metal slivers, and paint chips. Usually this material can be removed using cotton swabs and a suitable solvent. Holes which are severely damaged during service or during fastener insertion/removal may require reaming prior to ET. If reaming is required, contact appropriate cognizant engineer for component for an approved method.

4.5.6 Fastener Hole Inspection Equipment.



In general, the detection capability of manual bolt hole scanning is significantly less than automatic bolt hole scanning and thus SHALL NOT be substituted for automatic scanning unless specified in part-specific procedures or in specific written authority from the responsible engineering authority.

4.5.6.1 Manual Bolt-Hole Scanning.

CAUTION

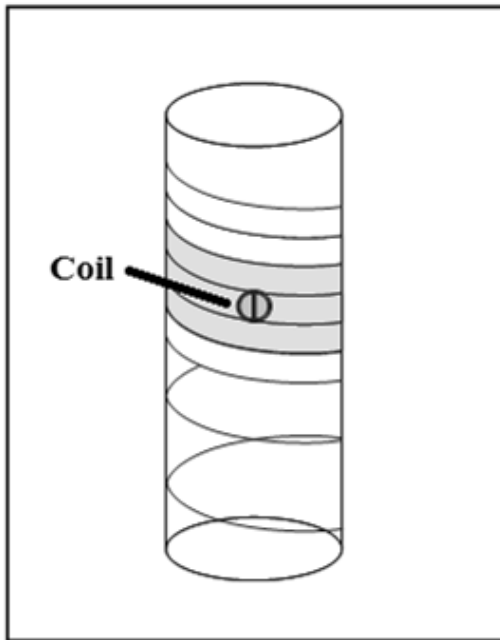
Automatic bolt hole eddy current (BHEC) inspection SHALL be accomplished in accordance with the applicable weapon system TO, and/or the appropriate work package in TO 33B-1-2 for the particular procedure to be performed. Unless otherwise stated, the specific weapon system TO always takes precedence over the manufacturer's recommendations or any general TO.

When used, manual scanning of bolt holes is performed at specified levels throughout the depth of the hole. Inspection is usually initiated with the center of the probe coil positioned immediately within the upper or lower edge of the hole so that the outside edge of the coil is even with the surface of the part. The probe coil position is adjusted to the specified level below the collar of the probe, and the probe is inserted into the hole until the probe collar rests against the surface of the part. Occasionally, intergranular stress corrosion (IGC) can occur along a plane roughly parallel to the part surface. The indication from this type of corrosion appears similar to an elliptical shape hole or a slow change in conductivity. Incorrect application of Band-pass filtering may mask the presence of IGC.

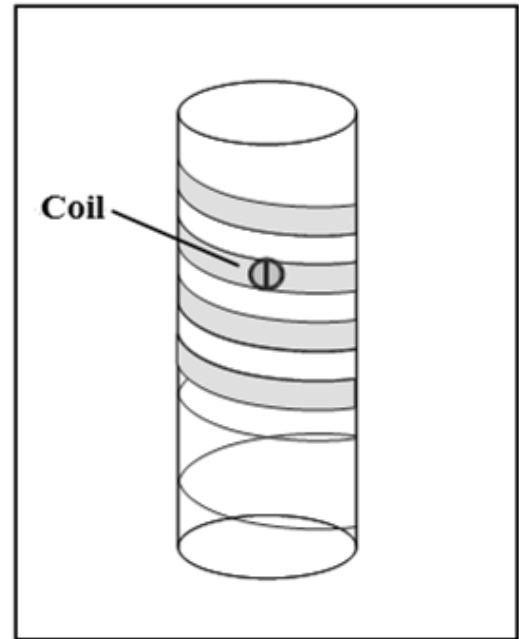
4.5.6.2 Automated Bolt-Hole Scanning. Automatic scanning is typically used for bolt hole inspection due to the increased detection capability over manual scanning. This equipment provides a hand held scanning unit which drives a probe in a helical pattern through the length of the hole, or rotates the probe at high revolutions per minute, at a constant speed while the operator indexes the probe through the hole. Equipment that rotates the probe in a helical pattern is referred to as a translational rotation scanner. Oftentimes high speed scanners do not have automated translational movement and they depend on the rate at which the operator pushes and pulls the probe into and out of the hole. Results can be retained on a strip chart recorder or displayed on a digital display.

4.5.6.2.1 The Rotary Scanner. The scanner spins the bolt hole probe at a certain speed, that has been set on the instrument during setup. The probe should be inserted into the fastener hole and indexed down the hole at a slow enough speed where the coil in the probe will scan the entire wall surface of the hole in a tight spiral, thus ensuring 100% surface coverage (see [Figure 4-32](#)).

4.5.6.3 Rotary Bolt Hole Probes. The most common bolt hole probe design is shown in [Figure 4-33](#). The probe consists of a probe shell with a 4-pin connector and a main probe body. The shell features two O-rings that hold and center the probe in the connector-receptacle of the scanner. Items provided by the manufacturer integral to probe construction or operation, such as O-rings, SHALL not be removed. The body consists of shank with an integrated ball at the end, called a "head". The shaft is split, and one of the two halves of the head contains the sensor coil. The split head provides spring-compliance to ensure that the sensor coil can be as close to the wall of the fastener hole as possible. When choosing a bolt hole probe, the diameter of the ball should be the same diameter or slightly smaller than the fastener hole to be inspected. This provides the "best fit" once the shank is spread and the tape is applied.

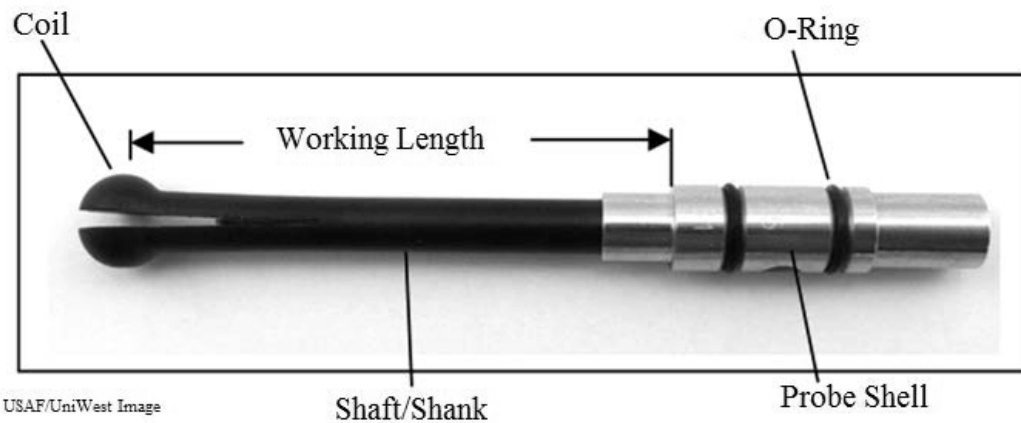


USAF/UniWest Image



H1600295

Figure 4-32. Proper Technique to Ensure 100% Coverage (Left), Incomplete Coverage (Right)



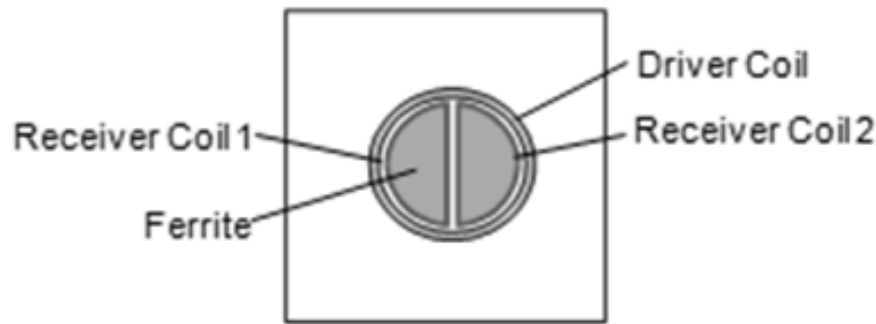
USAF/UniWest Image

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Figure 4-33. Typical Bolt Hole Probe Design

4.5.6.3.1 There are a variety of other designs, such as probes with conical- or cylindrical-shaped heads, or no heads at all. However, studies have shown that the ball-shape probe provides optimum flaw detectability throughout a fastener hole, including at the edge of both open ends. The ball-shape helps to ensure that the coil is in contact with the fastener wall, even if the probe is not quite aligned with the axis of the hole.

4.5.6.3.2 [Figure 4-34](#) shows the typical coil configuration in a bolt hole probe. The coil consists of two receiver coils, each of which is wound on a "D-shaped ferrite. The receiver coils are then placed side-by-side and a driver coil is wound around both. The receivers are connected in difference. This means if Receiver Coil 1 "sees" something it causes an upward signal response. If Receiver Coil 2 "sees" something it causes a downward signal response. This type of coil is called differential-reflection".



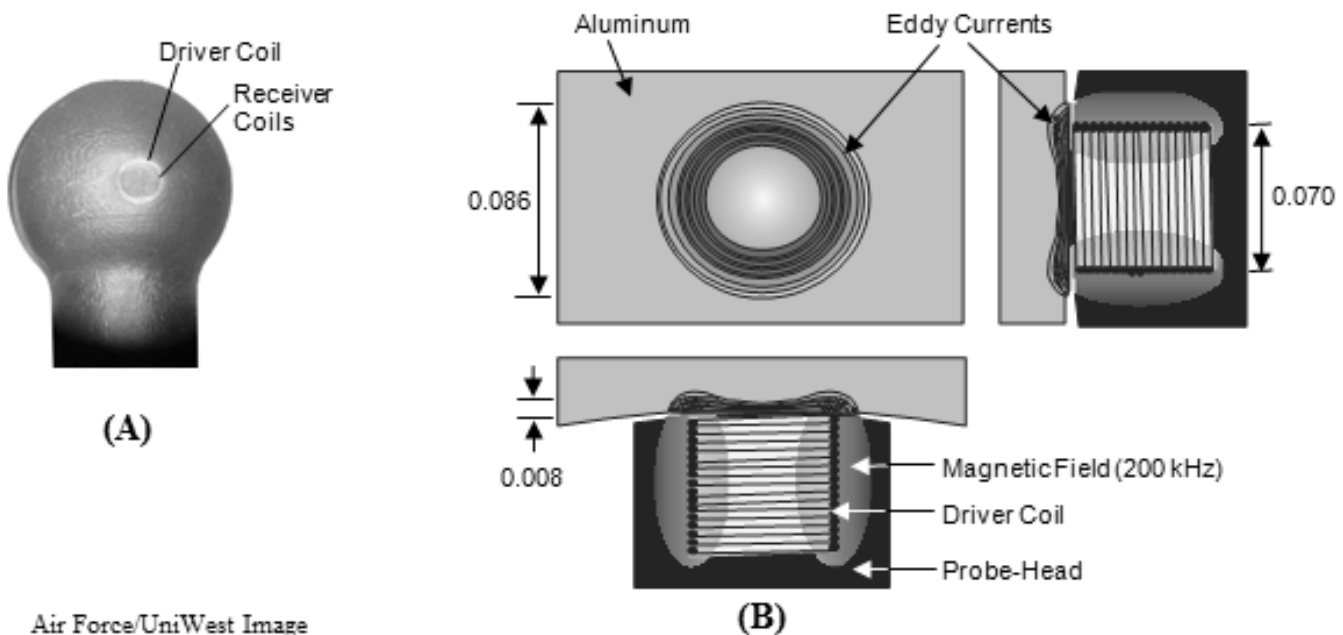
USAF/UniWest Image

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Figure 4-34. Coil Configuration in a Bolt Hole Probe

4.5.6.3.3 [Figure 4-35](#) (A) shows a typical bolt hole probe with a standard “D50” differential-reflection coil. The driver coil is the outer-most coil. The driver coil generates an alternating magnetic field that penetrates the conductive material. The material reacts by generating eddy-currents whose field opposes the primary electromagnetic field. Since the incoming magnetic field is spread-out, i.e. the effective field has a much larger effective area than just the coil diameter, the eddy currents are spread out.

4.5.6.3.4 [Figure 4-35](#) (B) shows the eddy current distribution for the probe shown in [Figure 4-35](#) (A). The eddy currents flow in the same circular pattern as the driver coil-windings, are strongest close to the coil-windings and slowly dissipate in the conductive material. The figure shows the outward extend and depth of the currents to the point where their strength has reached 37% of the strength at the surface (“standard depth-of-penetration”). In this example, the result is that in an aluminum component at 200 kHz, a probe with a 0.070” diameter driver coil will generate an eddy current field about 0.008” deep into the material, and will have a sensing area extending approximately 0.086” in diameter.



Air Force/UniWest Image

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Figure 4-35. Example of (A) Bolt Hole Probe and (B) Drive Coil Field and Generated Eddy Currents

4.5.7 **Probe Fit.** A probe that fits properly within the hole is critical to inspection performance. A poorly fitting probe will chatter in the hole, resulting in excessive lift-off and signal noise.

CAUTION

Only probes of the correct size SHALL be used to perform eddy current bolt hole inspection. Inspecting with a poorly fitting probe may result in missed crack indications.

4.5.7.1 The following is a simple procedure to ensure a good probe fit:

- a. Measure the bolt hole diameter if you do not know it;
- b. Select a probe with a size-range that fits the bolt hole;
- c. Tape the probe; do not insert it in the scanner;
- d. Insert it into the hole;
- e. If the probe can almost stand in the hole (if the hole is vertical and down), or hang inside the hole (if the hole is vertical and up), or not slip out of the hole (if the hole is horizontal) and if you can still smoothly spin it by hand, the probe fit is correct ([Figure 4-36](#)).
- f. If the fit is not correct shim some non-conductive foam or rubbery material into the split in the shank of the probe and try again.



Figure 4-36. Checking Probe Fit

4.5.8 **Probe Taping.** Bolt hole probes are manufactured using several types of materials depending on the probe type and manufacturer. Some probes are more durable than others. Probes made of soft plastics can wear and expose the coil windings in only a few uses, therefore it is always wise to carry a spare probe. One way to protect the coil is to use Teflon tape to cover the coil. Part of how long a probe lasts and what responses you observe during an inspection is how you tape the probe. Tape that is between 2.5 and 3.5 mils (0.0025-0.0035 inches) thick, is slightly "stretchy" and has adhesive backing SHALL

be used. The correct way to apply tape is to wrap it completely around the coil half of a split probe. The ends of the tape must be tucked in between the probe-split. The split probe provides a spring-like action to ensure the coil maintains contact with the bore surface when spinning. Therefore the tape SHALL NOT be wrapped completely around both halves of the split as that will prevent the probe from complying to the hole. [Figure 4-37](#) shows an example of an acceptably taped probe. In this example the tape smoothly covers the coil-half of the probe without wrinkles and the ends of the tape are tucked in between the split. [Figure 4-38](#) and [Figure 4-39](#) show examples of unacceptable taping. [Figure 4-38](#) shows tape covering only half the coil, which would allow the edges of the tape to come up during probe rotation in the hole, and [Figure 4-39](#) shows tape that was not smoothly applied and is wrinkled.



USAF/UniWest Image

H1600300

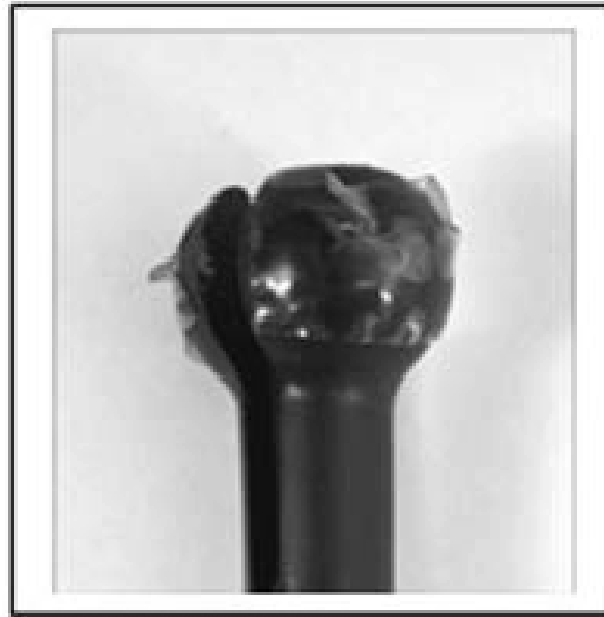
Figure 4-37. Examples of Acceptably Taped Bolt Hole Probes



USAF/UniWest Image

H1600301

Figure 4-38. Unacceptable Taping (Incomplete)



USAF/UniWest Image

H1600302

Figure 4-39. Unacceptable Taping (Wrinkled)

4.5.9 Lift-Off Compensation for Bolt-Hole Inspection. Lift-off compensation for bolt hole inspection is dependent upon the surface quality and dimensions of the hole. Optimum lift-off compensation is that which just suppresses lift-off variations within the hole, but does not provide excessive compensation. Excessive lift-off compensation can reduce sensitivity and increase noise. When using unshielded probes, specific amounts of lift-off compensation can be obtained by using a shim between the coil of the bolt hole probe and the hole wall. The thickness of the shim must equal the amount of lift-off compensation desired and must be relatively tough to prevent tearing during insertion and removal of the probe. Teflon tape SHALL be used for this purpose. Lift-off compensation is usually performed in the hole at a point away from the edge or at the center if the part thickness is less than 1/2-inch thick. More tolerance in lift-off compensation settings is permissible when using automatic scanning equipment or shielded probes.

4.5.10 Standardization Settings. The settings to standardize the instrument prior to inspection are based on response to a specified reference standard. A wide variety of test standards are used for bolt-hole inspection. They include cracked parts, electrical discharge machined (EDM) notches, notches cut with a jeweler's saw, differences in conductivity standards, and a multitude of other standards with larger notches and/or cracks. Each individual procedure SHALL specify the standard to be used and the required response in terms of meter deflection or indication size on a recorder, strip chart, or instrument display. When it is necessary to find small flaws and the possibility exists that different types of probes (coil size and frequency) may be used, it is necessary to use a reference with the same approximate dimensions as the flaws to be detected such as EDM notches.

4.5.11 Scan Speed and Pattern. Scanning speed and pattern must be considered during the setup procedure. This is especially important with manual scanning as probe response with manual scanning will not be the same as that during automated scanning. The distance between scans or the scanning increment is determined by the minimum crack size required to be detected. During manual scanning, the scanning procedure is repeated after setting the probe coil at each scanning position until the entire length of the hole has been inspected. When inspecting multiple layers, inspection should be performed in the materials of each layer adjacent to each interface. When the specific interface position between layers of similar material is not known, its position may be established by running the probe down past the interface and marking the position of maximum signal deflection. Setup and inspection SHALL be performed using the same scanning speed and pattern to ensure the best signal response and maximum scan coverage.

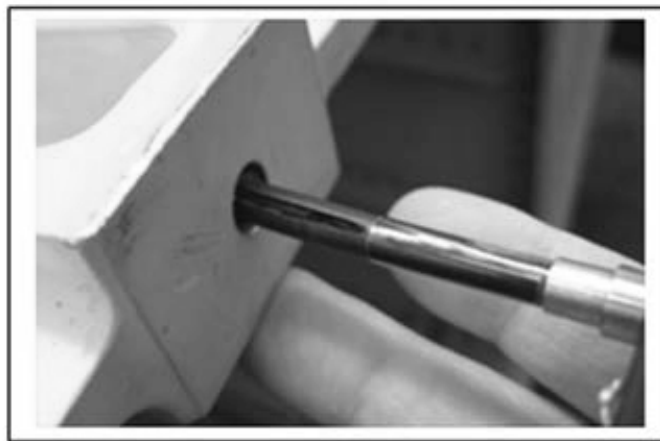
4.5.12 Probe Alignment. When inspecting a hole, the probe must be guided into the hole such that the axis of the probe is aligned with the axis of the hole (see [Figure 4-40](#) and [Figure 4-41](#)). This may be difficult to do, especially while monitoring the instrument screen at the same time. If the probe is not properly aligned the coil may not touch the bolt hole surface, preventing an effective inspection. The probe may also wobble or chatter, causing excessive noise.



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Figure 4-40. Correct Probe Alignment



USAF/UniWest Image

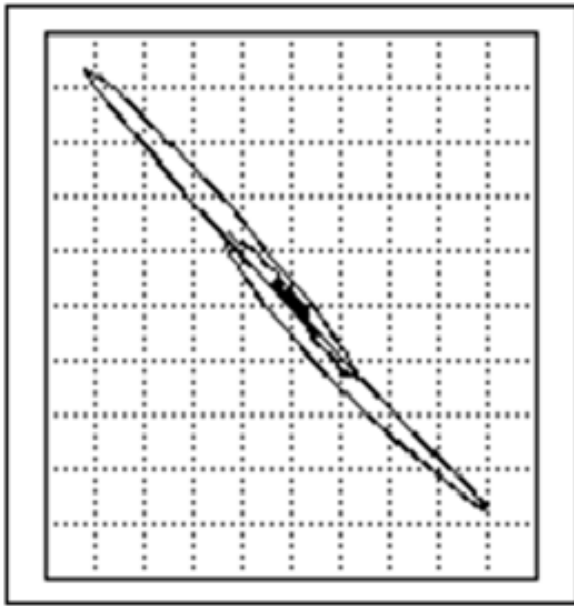
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Figure 4-41. Incorrect Probe Alignment

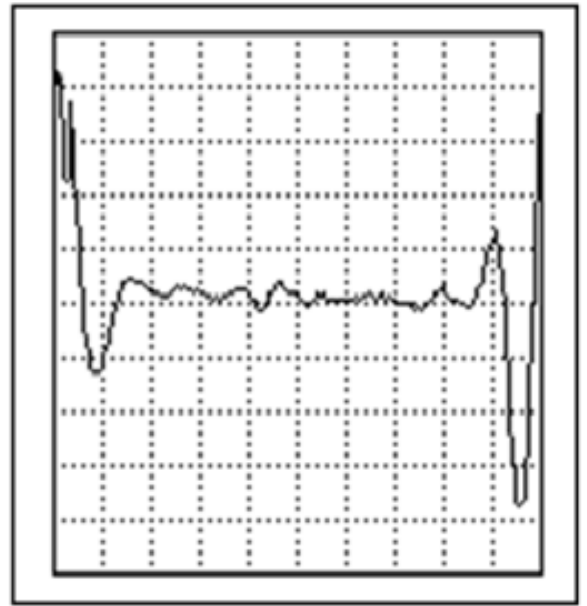
4.5.13 Probe to Edge Spacing. When inspecting for small cracks initiating from edges, probe-to-edge spacing can become a concern. Some approaches for overcoming these concerns are: increasing the frequency of the eddy current generating source, reducing the physical size of the coil, and adding shielding around the probe coil. Additional shielding will allow inspection closer to the edge because of the reduced volume of material sensed, and will result in greater sensitivity to smaller flaws. Probe-to-edge spacing becomes even more of a concern when the edge of the part is in contact with a ferromagnetic part such as a bearing or bushing. Again, minimizing the volume of material sensed by the probe will alleviate some of these irrelevant concerns and optimize signal response.

4.5.14 Bolt Hole Eddy Current Signal Interpretation. One of the single most important requirements for detecting a small crack is that the coil passes over the crack. Arguably, the technician's ability to interpret eddy current signal responses is

just as crucial to a successful inspection. To fully evaluate any indication, technicians should utilize both the impedance plane and sweep displays (Figure 4-42). The impedance plane provides the phase information, allowing the technician to assess whether an indication is lift-off from noise or a crack-like. Figure 4-43 illustrates why passing a differential-reflection probe over a crack results in a "figure-eight" or "double-loop" indication on the instrument display. The sweep display shows how many flaw indications are present and if setup correctly, what clock-position from a reference point each flaw is located in the hole. Used together, the impedance plane and sweep displays allow the technician to determine the orientation of the signal present, how many flaws are present, and their clock-position within the fastener hole.

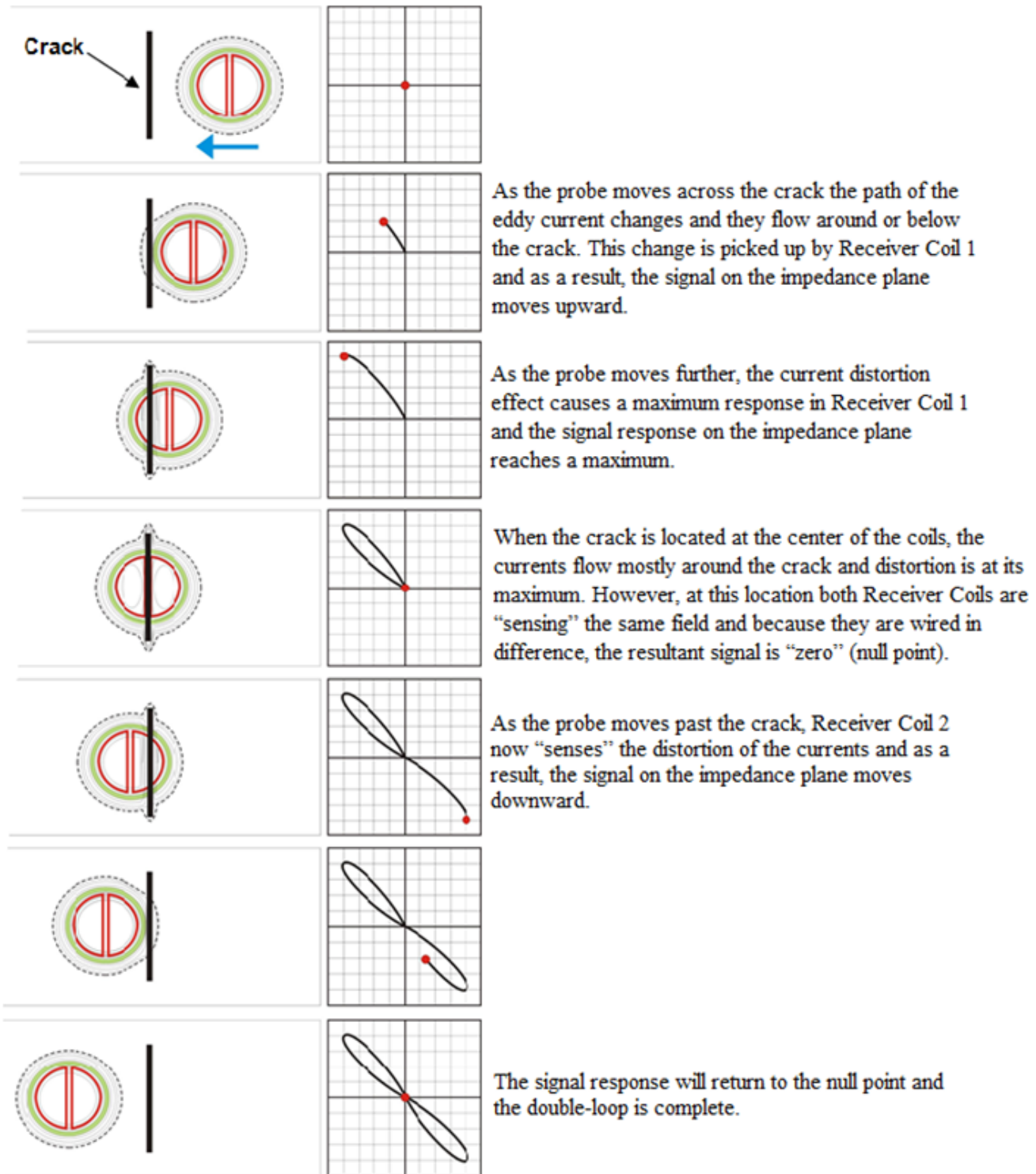


USAF/UniWest Image



H1600305

Figure 4-42. Impedance Plane Display (Left) and Sweep Display (Right)



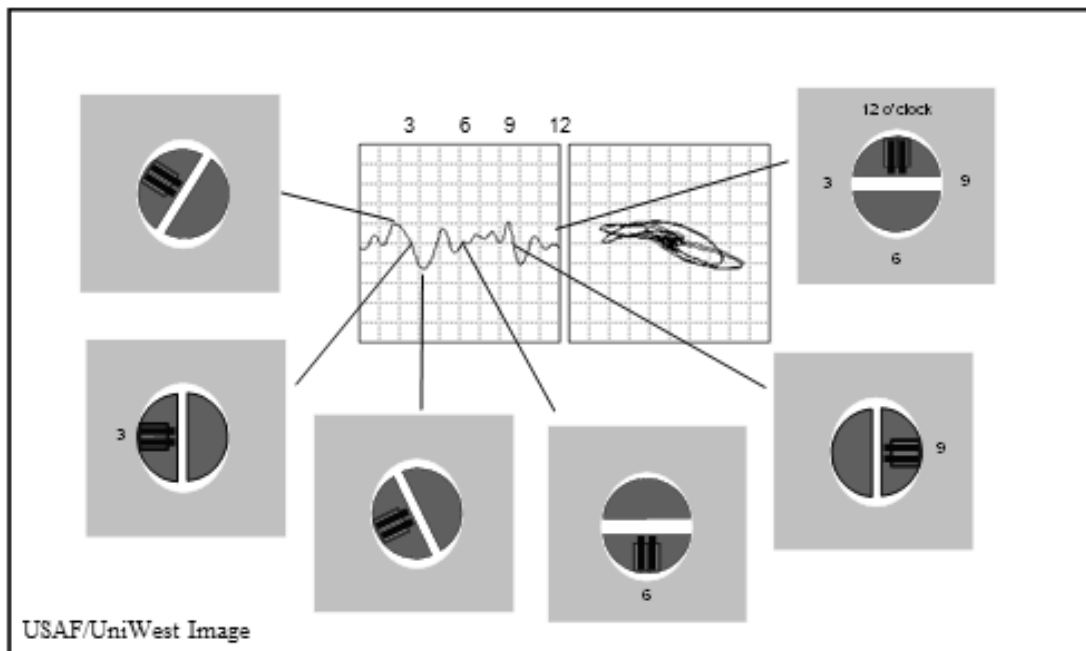
USAF/UniWest Image

H1600306

Figure 4-43. Bolt Hole Eddy Current Signal Responses from a Crack

4.5.14.1 **Out-of-Round Holes.** The effects from out of round holes most often occur in combination, making signal interpretation very difficult and can lead to false calls or missed cracks. It is very important to measure fastener holes prior to inspection if you suspect out-of-round condition. Studies have shown that crack detection is still possible at below 0.006- 0.008 inches out-of-round of nominal diameters; however, crack signal response is slightly distorted. Above these values, crack signals are generally distorted, are not distinguishable from noise, and noise levels exceed the reject limits. In field application, out-of-round holes typically exhibit unacceptable levels of signal noise. The following paragraphs describe some of the effects observed on the signal responses from out-of-round holes.

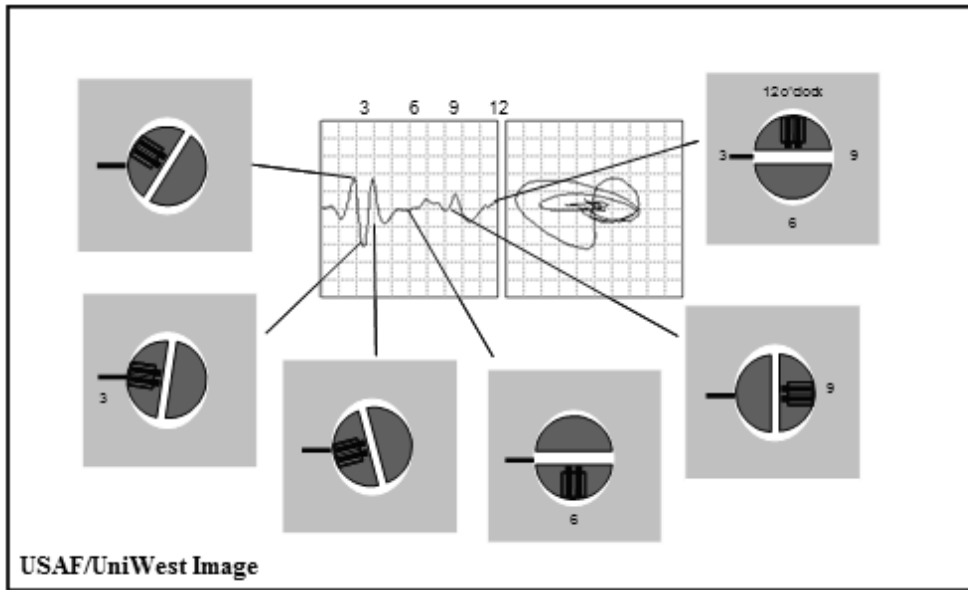
4.5.14.1.1 **"Goal Post" Response (no crack).** As the probe rotates in the fastener hole it will compress as it enters the narrow section (3-9 o'clock). As it enters the wider section (6-12 o'clock), it will expand, but the coil may no longer touch the surface and thus experiences lift-off. The result is a goal post-like pattern on the sweep-display and an indication on the impedance display similar to a crack indication, but at a different phase-angle ([Figure 4-44](#)). This excessive lift-off noise is rejectable.



H1600307

Figure 4-44. "Goal Post" Response in Aluminum

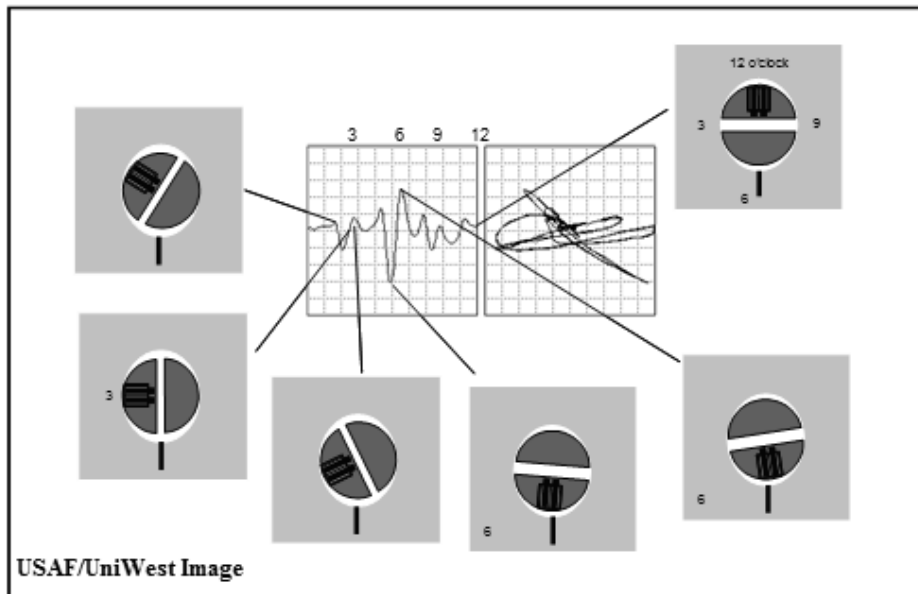
4.5.14.1.2 **Excessive Noise Response.** If there is a crack at the narrow section of an out-of-round hole, the lift-off effect can mask or distort the signal response from the crack, leading to difficulty in interpreting the crack response ([Figure 4-45](#)). Even if a crack-like indication were not present, the hole in [Figure 4-45](#) would still be rejectable, based on excessive lift-off noise.



H1600308

Figure 4-45. Excessive Noise Response in Aluminum

4.5.14.1.3 Excessive Noise and Crack Response. If there is a crack at the wider section of an out-of-round hole, the lift-off has two effects: it can mask or distort the signal response from the crack, and it reduces the signal amplitude (Figure 4-46). The hole in Figure 4-46 would be rejectable based on the noise, and due to a crack-like indication. If the hole is severely out-of-round the lift-off effect can be so great that there is no noticeable response from the crack.



H1600309

Figure 4-46. Excessive Noise and Crack Response in Aluminum

4.5.15 Fastener Holes Non-Removable Fasteners.

4.5.15.1 Inspection Application of Fastener Holes. If a fastener cannot be removed from a hole because of fastener type or location, inspection can be performed around the fastener to detect cracks growing from beneath the fastener head or nut. The size of detectable cracks is dependent upon the distance which must be maintained between the probe and the edge of the fastener. In many respects, this application is similar to inspection for cracks at the edge of openings and cutouts. Large low frequency probes and sliding reflectance probes can also be scanned over countersunk fasteners and identify cracks at the 1st, 2nd, and 3rd layers.

4.5.15.2 Probe to Fastener Spacing. If only required to detect relatively large cracks, such as those extending between two fasteners, eddy current inspection can usually be performed at a sufficient distance from the fastener heads to eliminate their effect on eddy current response. When small cracks must be detected, the probe must be positioned closer to the edge of the fastener, and the probe to fastener distance must be held constant during scanning. When fasteners fabricated of magnetic materials such as steel are used in nonmagnetic parts, a relatively large spacing must be used. Also, shielded probes can be used to minimize the distance between the probe and the fastener, allowing inspection near the fastener.

4.5.15.3 Scanning Guides Around Non-Removable Fasteners. For nonferrous (nonmagnetic) fasteners, the head of the fastener may be used as a probe guide. Only those fasteners which protrude from the surface of the part and are concentric with the hole can be used as guides. For fasteners with heads not concentric with the holes, such as hexagonal and serrated heads, a collar fitted to the fastener head can be used as a scanning guide. Most shielded probes can be scanned around steel fasteners without requiring a collar. Templates must be positioned concentric to the fastener head to assure relatively consistent response from defect-free material as the probe is guided around the fastener.

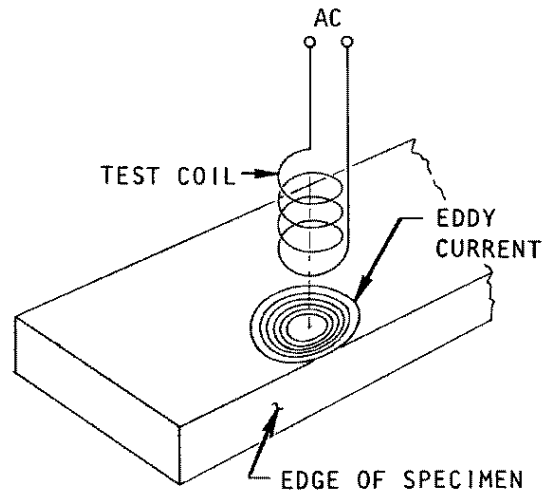
4.5.15.4 Probe Selection. As with many other flaw detection applications, the use of small diameter, radius probes is recommended. These probes permit better visibility of probe coil location and permit more flexibility in establishing spacing between the probe and the fastener. Radius probes are also less susceptible than flat surface probes to lift-off variations with changes in probe to surface angle.

4.5.15.5 Standards for Nonremovable Fastener Holes. Whenever possible, the standards for inspecting around the heads of nonremovable fasteners should duplicate as closely as possible the conditions of the inspection area. If cracked specimens representing the minimum crack size to be detected are not available, EDM slots cut at the edges of holes in the reference standard can be used. Material, geometry, hole size, fastener type, and installation should be the same for the reference part as for the inspection area, unless prior correlation with other available references has been established. Duplication of part geometry in the reference minimizes differences in response between references and cracks in the part.

4.5.16 Fillets and Rounded Corners.

4.5.16.1 Edges (Including Corners and Radii). For most eddy current techniques, the flow is circular and parallel to the surface of the part. If the flow of eddy currents intercepts an edge, corner, or radius of the part, the circular pattern is disrupted and the eddy currents are confined to a smaller volume. This action changes the magnitude and distribution of the eddy currents and is known as edge effect ([Figure 4-47](#)). As illustrated, the current density will be slightly greater at the edge of the part than at the interior. This will result in a slight increase in sensitivity to discontinuities located at the edge.

4.5.16.2 Crack Occurrence. Repeated bending loads applied to fillets and radii (rounded corners) of a part can lead to fatigue cracks. Fatigue cracks usually lie parallel to the radius. In formed radii, cracking usually occurs near the center of the radius where there is maximum thinning. In machined fillets or radii of extruded shapes where part thickness is greater at the center of the radius, fatigue cracks are more likely to occur at the tangent point of the radius. Stress corrosion cracking can sometimes occur in the radii and fillets of machined parts where tensile stresses are applied or areas of residual tensile stresses are exposed. Stress corrosion cracking is often promoted by the collection of moisture in these fillets and radii.



H0404536

Figure 4-47. Distortion of Eddy Current Flow at the Edge of a Part

4.5.16.3 Equipment Requirements for Fillets and Radii. In general, no special equipment is required for the inspection of fillets and radii. Adequate inspection can be performed using eddy current instruments with a radius tip probe or an equivalent test system. The radius of the probe tip must be less than the radius of the fillet to be inspected to ensure relatively constant contact between probe and part and thereby avoid excessive changes in lift-off. For inspection of the edges of radii or fillets, a thin plastic straight edge is desirable to maintain probe-to-edge spacing in the fillet. Occasionally, a fixture similar to those used for the bead seat radii in wheels can be used for fillets and radii. Fixtures decrease inspection time, improve inspection detectability, and assure complete coverage.

4.5.16.4 Reference Standards for Fillets. The best reference standard is an actual part with an actual flaw. If that can't be obtained then a specimen that represents the configuration of the part to be tested should be used for setup. Therefore, it is preferable to have a standard of the same material, finish, and radius as the fillet to be tested. A flaw or multiple flaws can be placed in the inspection area on the reference standard. The standard should contain at least one flaw equal to or smaller than the required flaw size of the inspection. Flat standards can be used if a standard of the required configuration is not available. Response from flat standards differs very little from response from cracks or slots in fillets or curved surfaces if a radius probe having a diameter substantially smaller than the fillet radius is used. Slots at edges are not interchangeable with slots located away from the edge.

4.5.17 Corrosion.

4.5.17.1 Test System Requirements for Corrosion Detection. The test system requirements for corrosion detection depends on the type and depth of corrosion for which inspection is performed. For uniform etch corrosion and for large pits, thickness measuring systems provide optimum detectability. For small pits and small areas of exfoliation or intergranular attack, the inspection requirements become similar to those for subsurface flaws. Instrumentation and probes with a broad selection of operating frequencies may be needed to cover the wide range of material types and thickness. Battery operated impedance plane analysis equipment can be used for corrosion detection and has many advantages for these applications in most field situations.

4.5.17.2 Types of Corrosion. Corrosion is a deterioration of metals by chemical action. Corrosion occurs where a conductive liquid, like water with ions, allows electrons to move from one piece of metal to another, or from one point to another in the same piece of metal. If salt, or another ion source, is added to water, the conductivity is increased and the rate of corrosion increases. Even condensation from damp air can provide enough water for corrosion to occur. The primary defenses against corrosion on aircraft are insulating dissimilar metals from each other, and protecting metal surfaces from moisture. Although corrosion may be classified in many ways, for purposes of detection, five principal forms are considered: (1) uniform etch, (2) pitting, (3) intergranular attack, (4) exfoliation, and (5) stress corrosion cracking.

NOTE

Further explanation of corrosion theory may be found in [Chapter 3](#) of NAVAIR 01-1A-509-1/TO 1-1-689-1/TM 1-1500-344-23-1.

4.5.17.2.1 **Uniform Etch.** Uniform etch corrosion is characterized by a general overall reduction in thickness of the metal in which some areas may be corroded more rapidly than others. This form of corrosion is readily detectable by visual means on exposed surfaces. Corrosion of inaccessible surfaces of thin metal structures is detectable with eddy currents if access is available to the non-corroded side. Detection of this type of corrosion then becomes a matter of thickness measurement with some variations expected because of small areas with increased corrosion or the presence of metallic materials at the far surface.

4.5.17.2.2 **Pitting.** Small localized areas of corrosion are termed pitting. Pitting can vary from pinpoint size to relatively large areas. The detection and measurement of corrosion pits must take these possible variations into account.

4.5.17.2.3 **Intergranular Attack.** In some materials, including many structural aluminum alloys, corrosion occurs preferentially along grain boundaries. Although slight amounts of corrosion pitting may be observed at the surface, the extent of damage is not readily observable by visual means because of the small crack-like penetrations. This type of attack is particularly applicable to aluminum alloys.

4.5.17.2.4 **Exfoliation.** Exfoliation corrosion initiates along grain boundaries parallel to the surface and propagates from these initiation sites. The corrosion products force the metal upward resulting in blistering and flaking of the metal. This corrosion form is most prevalent in structural aluminum alloys such as 7075-T6.

4.5.17.2.5 **Stress Corrosion Cracking.** The combination of a constantly applied residual or service stress and a corrosive environment can lead to stress corrosion cracking in many high strength metals. Residual stress can result from heat treating, machining, forming, shrink fits, welding, and assembly mismatch. Depending on the type of metal and the corrosive environment, stress corrosion cracking may or may not be associated with other forms of corrosion. This form of corrosion is primarily a crack and its detection has been covered under applications related to crack detection.

4.5.17.3 **Frequency Selection.** The choice of frequency depends on the type of corrosion to be detected and the thickness of the material through which inspection is being performed. Higher frequencies favor resolution of small pits or small areas of intergranular corrosion or exfoliation. Lower frequencies increase the depth of penetration.

4.5.17.4 **Probe Selection.** The probe must match the frequency at which the inspection for corrosion is performed. When more than one model of probe is operable at the inspection frequency, part and probe geometry are the determining factors in probe selection. For narrow contact areas, a smaller diameter probe may be advantageous. Larger diameter probes provide for greater averaging of thickness and provide somewhat better sensitivity in thicker areas.

4.5.17.5 **Corrosion Reference Standards.** Because of the unique action of each type of corrosion and its effect upon conductivity, reference standards must be fabricated from the same alloy, temper, and thickness as the material being inspected. When faying surfaces are involved in corrosion detection, the standard should be built up to simulate the joint including nonconductive shims for gap, paint, and primer thickness. Standards for pitting may also be used for exfoliation and intergranular attack. Standards should also have approximately the same geometry as the part.

4.5.17.6 **Inspection Procedure-Corrosion Detection.** Detection of corrosion with eddy current techniques is applied to aircraft skins when corrosion may occur on inaccessible interior surfaces. Corrosion usually results in areas where moisture is entrapped. If relatively uniform thinning is expected, corrosion detection may be simply a matter of thickness measurement. In most instances, corrosion is confined to smaller localized areas of relatively small diameter. As skin thickness increases, sensitivity to small areas and shallow depths of corrosion is reduced.

4.5.17.7 **Part Preparation.** Prior to inspection, all foreign material should be removed from the area to be inspected. Any roughness, sharp edges, or protrusions that could damage the probe or cause errors in readings should be removed by light sanding within the limits of the applicable TO. The locations of all fasteners, edges, and changes in structure on the far side of the inspection surface should be established and marked with an approved removable marker to aid in the interpretation of inspection results. Paint removal is not required if it is relatively uniform and not loose or flaking. Because of the wide variety of corrosion attack, inspection SHALL be performed in accordance with the applicable TO

4.5.18 Field Measurement of Conductivity. Eddy current instrumentation is used for determination of electrical conductivity under production and field conditions. The eddy current instruments are calibrated against standards of known conductivity. When available, instruments designed specifically for measurement of conductivity are used. These instruments measure conductivity directly in % IACS.

4.5.18.1 Conductivity of Aluminum Alloys. Conductivity measurement is applied most often to aluminum alloys. This application results from the extensive use of aluminum alloys in the aerospace industry and the wide variation in the electrical conductivity and mechanical properties between different alloys and heat treatment. For most aluminum alloys in common usage, specific conductivity ranges have been established for each alloy and temper. The conductivity ranges for most of the aluminum alloys commonly used in aircraft structural applications are listed in [Table 4-4](#) in [Paragraph 4.8](#). These values represent a collection of values obtained from various airframe manufacturers and Government agencies. The ranges include all values obtained for standard heat treatments except for extreme values obtained from one or two sources which were clearly outside the ranges of all other lists. If a measured conductivity value for an aluminum alloy and temper is outside of the applicable range, its mechanical properties SHOULD be considered suspect. Measurement of conductivity values SHOULD be in accordance with SAE-AMS-H-6088, ASTM E1004 or another suitable standard.

4.5.18.2 Heat Treatment Effects on Aluminum Conductivity. An aluminum alloy has the highest conductivity and lowest strength when it is in the fully annealed temper. After quenching from the solution heat treating temperature, the strength is increased and the conductivity decreased. Many aluminum alloys are unstable for a considerable period of time after solution heat treatment, even if held at room temperature during this time. A certain amount of atom migration takes place to initiate the formation of submicroscopic particles. This process, sometimes called natural aging, increases the strength of the alloy but has either no effect on conductivity or a slight decrease in the conductivity value. Some aluminum alloys remain unstable for such long periods after quenching they are never used in the solution heat treated condition (e.g., 7075). If a solution heat treated alloy is precipitation hardened by heating at relatively low temperature (generally 200- 450°F), alloying atoms form small particles. At a critical size and distribution of particles, the strength of the aluminum alloy reaches a maximum. Conductivity increases during the precipitation hardening or artificial aging process. If aging is carried on beyond the point where optimum strength is obtained, strength will decrease, but conductivity will continue to increase.

4.5.18.3 Discrepancies in Aluminum Alloy Heat Treatment. Variations from specified heat treating practice can result in aluminum alloys with strengths below required levels. Heat treat discrepancies include changes or misapplication of the following processes:

- Solution heat treating temperature
- Solution heat treating time
- Quenching practice
- Aging temperature
- Aging time
- Annealing temperature and time
- Uncontrolled temperature application

4.5.18.4 Applications of Conductivity Measurement.

NOTE

The Tables in [Chapter 4, Section VIII](#) provide conductive values and ranges for reference. However, when determining the serviceability of an aircraft component or structure based on conductivity, the appropriate conductivity range should be identified or confirmed by cognizant engineering.

4.5.18.5 Separation of Alloys and Tempers. Conductivity measurement can be used to separate mixtures of two or more alloys and/or tempers. Separation is possible when the electrical conductivity of each grouping is clearly different. The process of separation may be accomplished with an instrument calibrated in % IACS.

4.5.18.6 Conductivity Measurement and Magnetic Materials. Use of general purpose instruments may be extended to the separation of magnetic materials where the product of permeability and conductivity of each of the alloys is clearly different. Conductivity meters will not measure the conductivity of magnetic materials.

4.5.18.7 Typical Application. Eddy current techniques are used to separate metal parts or raw materials of similar geometry which have lost alloy and/or temper identification and have become mixed in manufacture or storage. Such procedures can be applied at any stage in the processing, storage, or service of the material.

4.5.18.8 Control of Heat Treatment. The relationship between electrical conductivity and heat treat condition has permitted the use of eddy current techniques for checking the adequacy of heat treatment in aluminum alloys. In this application, conductivity measurements by eddy current techniques are used to supplement a minimum amount of tensile testing and/or hardness testing. Eddy current conductivity measurements are particularly valuable for determining the uniformity of heat treatment of large and complex aluminum alloy structures when tensile specimens are not obtainable and part geometry limits accessibility for hardness testing. Adequacy of heat treatment of aluminum alloys is determined by conformance of the material to the pre-established conductivity ranges. This method of heat treat control has been applied extensively to aluminum alloys. Eddy current techniques are used for evaluation of heat treatment of steels. Generally, more sophisticated instrumentation is used for steels, but general purpose instruments can be used for many applications. Acceptance standards are usually used for eddy current inspection of steel. Conductivity measurement is applied to a lesser degree for heat treat control of copper and magnesium alloys. Eddy current techniques can be used for heat treat control in any alloy system where consistent but different conductivity ranges or permeability values occur with the various heat treating conditions. Conductivity measurement has not been established as a method of determining heat treat response in titanium alloys. Differences in conductivity between various heat treat conditions for most titanium alloys are insufficient to permit determination of temper.

4.5.18.9 Determination of Heat and Fire Damage. A common application of conductivity measurement in field applications is the determination of heat and/or fire damage to aircraft structures. Because of the extensive use of aluminum alloys for aircraft structures and their sensitivity to mechanical property losses at relatively low temperatures, greatest experience and data have been generated for these materials. Heat and fire damage to other metals can be detected if temperatures become high enough to affect conductivity, permeability, and mechanical properties. Damage is detected in aluminum alloys as changes in conductivity from the specified range for the alloy and temper being inspected. Heat and fire damage usually vary over a part because of non-uniform application of heat. Non-uniform heat application, in turn, results in variations in electrical conductivity. Unless the temperature and time of heat application is known, or testing is performed on a number of parts with the same history of heat application, quantitative values of mechanical properties cannot be established from the electrical conductivity values. Hardness testing and conductivity measurement give a good indication of heat and fire damage. Both test methods must be performed to get an idea of the amount of damage.

4.5.18.10 Conductivity Measurement. To determine conductivity directly, eddy current instruments are available which provide a value of conductivity in % IACS. Percent IACS measuring instruments usually require only two standards of known conductivity for calibration. If direct conductivity measuring equipment is not available, general purpose eddy current equipment may be adapted for measuring conductivity. Use of general purpose equipment requires a larger number of standards to establish a calibration curve. The number of standards necessary for a conductivity measuring application is determined by the range of conductivity to be covered and the accuracy required. General purpose equipment can also be used in a go-no-go function to separate metals above and below a specified conductivity value. A standard representing the minimum acceptable or disallowable conductivity must be available.

4.5.18.11 Equipment for Magnetic Materials. Impedance plane analysis instruments can be used to measure the conductivity of ferromagnetic materials because the permeability and conductivity can be separated in phase. The combination of conductivity and permeability, in many cases, can be related to variations in alloy, temper, and strength. General purpose meter type instruments can then be used to separate or grade various levels of properties. The number of standards required depends on the number of categories of materials to be established.

4.5.19 Effects of Variations in Material Properties.

4.5.19.1 Conductivity. Conductivity variations can occur in metals as a result of improper heat treatment or as a result of exposure to excessive temperatures during service and cold working. These are the conditions for which eddy current inspection is usually performed. Conductivity variations can stem from other sources. Separation of elements during solidification of metals can lead to either localized or uniform differences in conductivity. For instance, a variation in conductivity can exist with increasing depths beneath the part surface particularly in heavier sections which have not been worked extensively. Slight differences in heat treating time, temperature, or quenching rates imposed by limitations in heat-treating fa-

ilities or changes in part configuration also lead to variations in conductivity of a part. Localized cold working of metals, when not followed by heat treatment to relieve residual stress, can reduce electrical conductivity. Many of the variations are considered normal to the processing of the parts and the conductivity lies within the acceptable range for the alloy specification and temper. Conductivity outside the specified range for a given alloy and temper should be considered unacceptable and further investigation should be performed using hardness testing techniques.

4.5.19.2 Edge Effects. If the electromagnetic field of the probe is affected by the geometry of the edge of the part, an error will occur in the measurement of the conductivity. The probe should be located several probe diameters away from the nearest edge or transition boundary.

4.5.19.3 Curvature. Lift-off effects caused by the probe-to-curve surface fit-up will cause an error in the conductivity measurement. On curved surfaces, the smallest practical probe should be used to minimize lift-off effects.

4.5.19.4 Clad Materials. Cladding will affect the measured conductivity of the base metal. The degree to which the cladding will affect the value obtained depends on the conductivity of the cladding, the thickness of the cladding, and the operating frequency. Present applications are usually limited to “Alclad” aluminum alloys in the range of 0.050 to 0.080-inch thick using conductivity meters with operating frequencies of 60 kHz. Special conductivity ranges are required for clad aluminum alloys. The thicknesses of cladding, which are usually based on a percentage range of the overall thicknesses, can vary slightly because of normal tolerances. At 60 kHz, conductivity readings from aluminum alloys less than 0.050-inch in thickness are affected by both cladding and part thickness. Eddy current testing of complex cladding systems is still in an experimental stage for the most part.

4.5.19.5 Magnetic Permeability. Direct meter measurement of electrical conductivity is applicable to nonmagnetic materials with a relative magnetic permeability of one or nearly one. If magnetic permeability exceeds one, it will produce a bridge unbalance in the meter system which cannot be separated from the conductivity measurement and erroneous readings will be obtained. For this reason, conductivity of steels, nickel, and other magnetic materials cannot be determined with conventional eddy current conductivity meters. Some stainless steels (e.g., 300 series) are essentially nonmagnetic in the annealed condition, but slight amounts of cold working or exposure to extremely low temperature can cause transformation to a magnetic structure. Impedance plane analysis equipment can readily separate magnetic permeability and conductivity, allowing an accurate measurement of conductivity of ferromagnetic materials.

4.5.19.6 Geometry. Any change in part configuration that affects distribution or penetration of eddy currents will result in erroneous electrical conductivity readings. The following sources of error are included in these categories:

- Proximity to part edges or adjoining structure
- Metal thickness less than the effective depth of penetration in the metal
- Excessive curvature of part surface

4.5.19.7 Metal Thickness. If metal thickness is less than the effective penetration of the eddy currents, the measured conductivity will differ from the true value. Notice the effective penetration depth is approximately three times the standard depth of penetration. With meter equipment it is important to determine the operating frequency of the instrument. The operating frequency must not exceed the effective penetration depth of the material being tested. Impedance plane analysis equipment has a very wide range of operating frequencies, and the frequency can be adjusted to limit penetration to less than the effective depth. The standard depth can be determined by using the equation in [Paragraph 4.8.7](#). Special slide rules are available for calculating depth of penetration. Effective depth is approximately three times greater than the standard depth calculated by this equation. The material thickness must be greater than the effective depth or errors in conductivity measurement will occur.

4.5.20 Effects of Variations in Test Conditions.

4.5.20.1 Frequency. Because frequency affects distribution of eddy currents within the test part, it affects the minimum thickness which can be measured without special adjustments. Higher frequencies permit measurement of thinner metals without compensation for thickness. Select a frequency such that the effective depth of penetration (2.6δ) is contained within metal being tested to reasonably accurate conductivity measurement. However, the higher frequencies are more strongly affected by localized variations in conductivity or by conductive coatings and cladding on metals. Excessive high frequencies SHOULD NOT be used for conductivity measurements.

4.5.20.2 Probes for Conductivity Measurements. With instruments designed for conductivity measurement, probes are carefully matched to the instruments and are usually obtained from the instrument manufacturer. Probes for conductivity measuring instruments are larger than those normally used for defect detection. This design provides for averaging of conductivity over a relatively large area. Probes are designed with plastic or ceramic shoes to prevent damage to the coil. With continued use, wear on the face of the probe reduces the coil-to-surface distance, and calibration cannot be obtained. As wear occurs, the probe shoe must be changed and the instrument recalibrated.

4.5.20.3 Lift-Off Effects on Conductivity. Meter type conductivity measuring eddy current instruments often have a preset lift-off adjustment. The lift-off adjustment is usually set during calibration of the instruments. Applicable maintenance manuals describe the procedures that can be performed by trained NDI personnel. With probe wear and changes in instrument electrical components over a period of time, lift-off adjustment can change. Therefore, when conductivity measurements are to be performed on rough surfaces or through thin nonconductive coatings, lift-off adjustment SHOULD be checked prior to performing the measurements. After calibrating an instrument against the conductivity standards, lift-off adjustment SHOULD be checked against a specimen with conductivity representative of the test part. Lift-off, greater than the amount of preset lift-off adjustment (if any), results in errors in conductivity readings.

4.5.20.4 Temperature Effects on Conductivity Measurements. Higher temperature increases the thermal activity, of the atoms in a metal lattice. The thermal activity causes the atoms to vibrate at high amplitude about their position in the lattice. This thermal vibration of the atoms increases the chances of a collision with electrons in the material. This increases the resistance to electron flow, thereby lowering the conductivity of the metal. Lower temperatures reduce thermal oscillation of the atoms resulting in an increased electrical conductivity. The conductivity of standards is usually determined at a specific temperature; 68°F (20C) is most commonly used. Typical conductivity values and allowable conductivity ranges are also established at approximately this temperature. If all instrument calibration and conductivity measurements could be performed at this temperature, errors in conductivity measurement related to temperature variation would not occur and/or temperature compensation would not be required. In field applications, testing temperatures can conceivably be anywhere in the range of 0°F to 120°F. Unless precautions are taken in selection of standards, calibration of the instrument, and testing, errors will occur in the measured conductivity values. Two ways in which erroneous readings may be obtained are:

- Difference in temperature between standards and test part
- Difference in temperature at which conductivity of the standard was originally established and the temperature at which instrument calibration and conductivity measurements are performed

4.5.20.5 To prevent errors from differences in temperature between the standard and test part, the instrument and standards SHOULD be allowed to stabilize at the test part temperature before calibration and conductivity measurements are performed. Measurements SHALL NOT be taken if part and standards temperature differ by more than 10°F. Even though the standard and test part are at the same temperature, errors in determining conductivity values occur when the measuring temperature differs from the temperature at which the conductivity of the standards was originally established. The magnitude of the error becomes larger as this difference in temperature increases.

4.5.21 Flaw Detection. Service-induced cracks in aircraft structures are generally caused by fatigue or stress corrosion. Both types of cracks initiate at the surface of a part. If this surface is accessible, either by direct surface contact or by penetration of the eddy current field through the material, ET can be performed with a minimum of part preparation and a high degree of sensitivity. When establishing an eddy current technique for crack detection, the following factors must be considered:

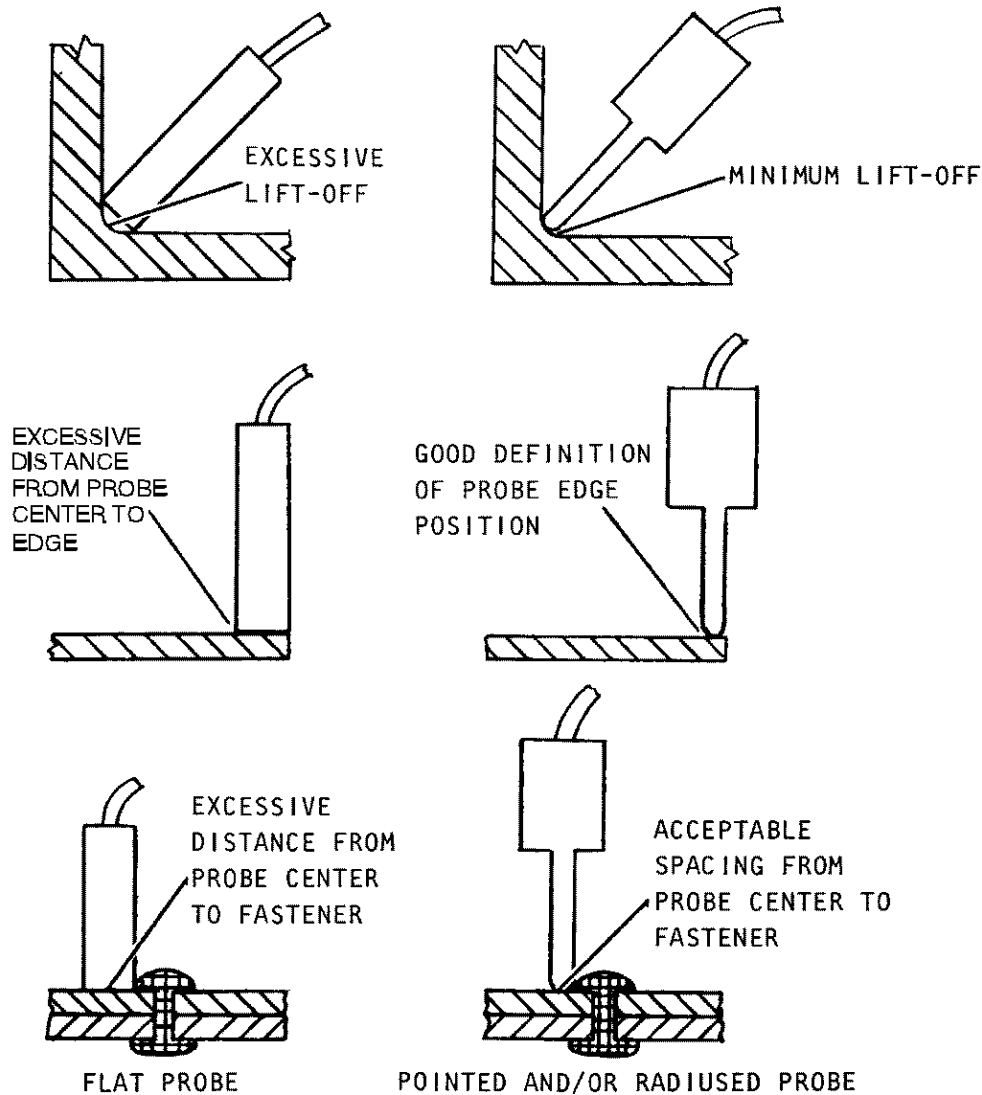
- Test system capabilities
- Type of material to be inspected
- Accessibility of inspection area
- Location and size of cracks to be detected

4.5.21.1 Capabilities of Test System. The test system for crack detection includes the probe(s), the eddy current instrument, any additional recording or measuring instruments, and reference standards. A wide variety of eddy current units are fabricated for general purpose ET. General purpose eddy current inspection instruments are used for flaw detection. In the aerospace industry, very few general purpose eddy current instruments use meter displays. For the most part, two-dimensional displays of the impedance plane that display the detailed phase and amplitude analysis are used.

4.5.21.1.1 Probe Selection. The primary consideration in selecting an eddy current probe is the type of inspection being performed. To detect small cracks, a shielded probe coil of small diameter with a ferrite core is desirable to concentrate the induced field into a small volume. A small crack has a proportionately greater effect on a small probe field than on a large probe field. In the event encircling coils or inside coils are used, short or narrow coils are preferred for inspection of small localized conditions. Spacing of the coils must be considered when determining the resolution required. The coil or probe must match the frequency range and output impedance of the instrument being used. In general, cracks whose lengths are less than half the diameter of the coil are difficult to detect.

4.5.21.1.1.1 Probe Housings. The housing for most general purpose surface probes is cylindrical in configuration and from 1/8 to 3/8-inch in diameter. Probes can be shielded with either non-permeable (μ) metal or ferrite to concentrate the field. When defect detection around fasteners, in radii, or adjacent to edges is required, it is often advantageous to have a pointed or small rounded tip at the end of the probe. The pointed end allows the probe to be inserted closer to the inspection surface, or edge, and permits better visibility of probe coil position. The advantages of a pointed probe for these applications are illustrated in [Figure 4-48](#). For inspection of bolt holes, special probes are manufactured that permit contact with the side of the hole at any desired level in the hole. For inspection areas where accessibility is a problem, or where probe positioning is critical, it is often desirable to fabricate special probe housings as an aid in performing the inspection. The use of special housings can greatly decrease the loss of sensitivity associated with probe wobble and lift-off during scanning. When large quantities of parts are to be inspected, special probes present a distinct advantage if they enable per unit inspection time to be reduced. Test procedures and technical orders for the ET of specific aircraft components SHOULD specify the probe and special fixtures and may specify the design also. Probability-of-Detection studies have indicated that probe guides and special fixtures increase inspection reliability and SHOULD be used instead of freehand scanning.

4.5.21.1.1.2 Probe Types. The four different probe types are absolute, differential, reflectance, and remote field probes. Each type of probe is discussed in [Paragraph 4.4.2.1](#).



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Figure 4-48. Advantages of Pointed and Radius Probes for ET

4.5.21.2 **Inspection Material.** The material from which the inspection part is fabricated is of primary importance when determining if eddy current inspection should be used and the limitations involved with this method. Conductivity and magnetic permeability influence frequency requirements, instrument choice, signal-to-noise ratio, filtering needs, resulting sensitivity, and reliability of inspection. If surface cracking is to be detected in ferromagnetic material, a high frequency can be used to limit penetration or a high pass filter can be used to minimize permeability problems.

4.5.21.3 **Accessibility.** Most of the eddy current equipment presently available for use in the field is small, portable, and battery powered. This permits its operation in relatively tight quarters. However, eddy current inspection is only feasible for surface or near surface conditions because of its limited depth of penetration. For this reason, direct access to the surface to be inspected is usually preferred. Sufficient freedom of movement must be available in the area to be inspected to allow positioning and movement of the probe to detect or measure the specified variable. The inspection area must be visible to enable the inspector to determine the position of the probe. Alternatively, a special probe, a fixture, or a guide can be used to position and hold probes in the required location. The extent of disassembly required for inspection should be defined in applicable written procedures.

4.5.21.4 Frequency Requirements. As the eddy current test frequency is increased for a specific eddy current application, the eddy currents are confined to a smaller volume adjacent to the inspection probe coil. This concentration increases the proportion of generated eddy currents intercepted by a small crack or other defect. Higher frequencies should then provide better response to the smallest defects. This statement holds in general, but other conditions may limit the sensitivity when using higher frequencies. In some instruments, high induction losses limit instrument output at these higher frequencies. Lower frequencies may be required for increased penetration to detect subsurface or far surface flaws. Optimum sensitivity to cracks or other flaws generally occurs in specific frequency ranges for each combination of metal, flaw size and flaw depth. Operating frequency ranges can be established for each application by using the calculated depth of penetration using the conductivity and permeability of the material. These calculations SHOULD be confirmed with the use of reference standards which simulate the anticipated flaws to be detected.

4.5.21.5 Signal-to-Noise Ratio. As the gain of a test system is increased, a background of electrical noise will be observed. This may be represented by erratic meter movement, excessive background signals on a waveform display, or excessive, random patterns on a recorder. This “noise” can be the result of random variations in the electrical system of the test instrument, normal variations in material properties, or stray electrical signals from other electrical devices. Signal-to-noise ratio is not a function of the instrument alone, but is also dependent upon lift-off, surface finish, conductivity, and permeability variations within the inspection part. For an eddy current test instrument or any other electrical test instrument to be useful, it must provide flaw signal information greater than the background noise of the test system. Otherwise the inspector could not see the difference between the flaw signal and the background noise. For maximum reliability in ET, a high signal-to-noise ratio is desired. No specific signal-to-noise ratio is mandatory, but a minimum of 3-to-1 is desirable for flaw detection.

4.5.21.6 Signal-to-Noise Ratio and Sensitivity. As the required crack size to be detected is decreased, the gain or sensitivity of the eddy current instrumentation must be increased to provide readable indications from small cracks. The higher gain results in greater indications from small cracks. The higher gain also results in greater response from variables other than cracks and the noise level increases. This decreases the signal-to-noise ratio, making it more difficult to observe the small flaw indication. The decrease in signal-to-noise ratio lowers the reliability of the inspection. Therefore, an increase in gain will increase the amplitude of the flaw signal as well as increase the level of noise. Thus, useful sensitivity must be measured in relation to the noise of the test system.

4.5.21.7 Influence of Frequency on Noise. Increasing the operating frequency for ET improves the sensitivity to near-surface defects, but also tends to increase noise from surface related factors such as lift-off scratches, rough surface, and probe wobble.

4.5.21.8 Suppression Techniques. Suppression techniques are used to eliminate or reduce instrument response to one or more inspection variables to permit better identification of changes in the parameters of interest during eddy current inspection. When the display is rotated as previously indicated, lift-off variations produce little or no signals in the vertical direction. Even though the crack signal is predominately horizontal, it has a significant vertical component. This vertical component can be amplified independently and monitored visually or electronically. A box gate (alarm) can be used to electronically monitor the vertical component of indications and set off visible and audible alarms on the equipment to draw inspector attention. The typical box alarm is a rectangle whose position, height and width can be adjusted to selectively monitor a portion of the impedance plane. Box alarms can be set to trigger when the crack indication signal enters the box (Positive) or when the signal leaves a box (Negative). Where liftoff is horizontal and crack indications are vertical, a “positive” triggered box alarm can be set slightly above the path of the lift-off lines and low enough to be crossed by crack indications. In the example described, defect indications will enter the box alarm over a fairly large area of lift-off conditions while the slight vertical component of these lift-off responses remains outside.

4.5.21.9 Resolving Power. The ability of a test system to separate the signals from two indications that are close together is defined as “resolving power.” This property plus sensitivity must be considered in every flaw evaluation situation. Probe design, test frequency, and instrumentation design are all factors in determining the resolution of an eddy current system.

4.5.22 Lift-Off Effects.

4.5.22.1 Sources of Lift-Off Variations. During eddy current inspection, changes in spacing between the probe coil and the inspection surface will cause variations in test coil impedance. These changes in lift-off result from surface roughness, slight contour changes, probe wobble, probe bounce, and inconsistent thickness of nonmetallic coatings, such as paint, primer, and anodic coatings. The magnitude of impedance changes resulting from small amounts of lift-off variations can exceed the response from a crack. Consequently, some means of eliminating or separating this effect must be provided.

4.5.22.2 Lift-Off Suppression. One option for minimizing lift-off effects from the variable to be measured is the use of impedance plane analysis, where the phase direction of the response from the desired variable is separated from the phase direction of signals caused by lift-off variations. This type of analysis can be performed using any of the waveform display instruments that provide amplitude and phase of the signal. The small, meter readout type battery-powered instruments provide only a total amplitude measurement and require some means of lift-off suppression. For these instruments, lift-off compensation is obtained by selection of an off null operating point. The off null operating point is selected to provide equal current flow (meter reading) with the probe on bare metal and at a designated amount of liftoff. ET using small amounts of lift-off compensation or adjustment is also termed intermediate layer technique. The amount of lift-off adjustment is selected to minimize any surface roughness or variation in coating thickness on the part.

4.5.23 Lift-Off Compensation Methods.

4.5.23.1 Impedance Plane Analysis Instruments. Instruments that present the phase and amplitude of the signal on digital display have phase rotation controls which allow the eddy current signal to be rotated until the phase is in a particular orientation. For instance, the phase can be rotated until the lift-off signals move in a horizontal motion, with increasing lift-off represented by movement to the left or right on the screen. Flaw signals or loss of conductivity will generally be in a vertical direction. The phase angle and amplitude of an indication will depend upon the depth of the flaw and the frequency of the test.

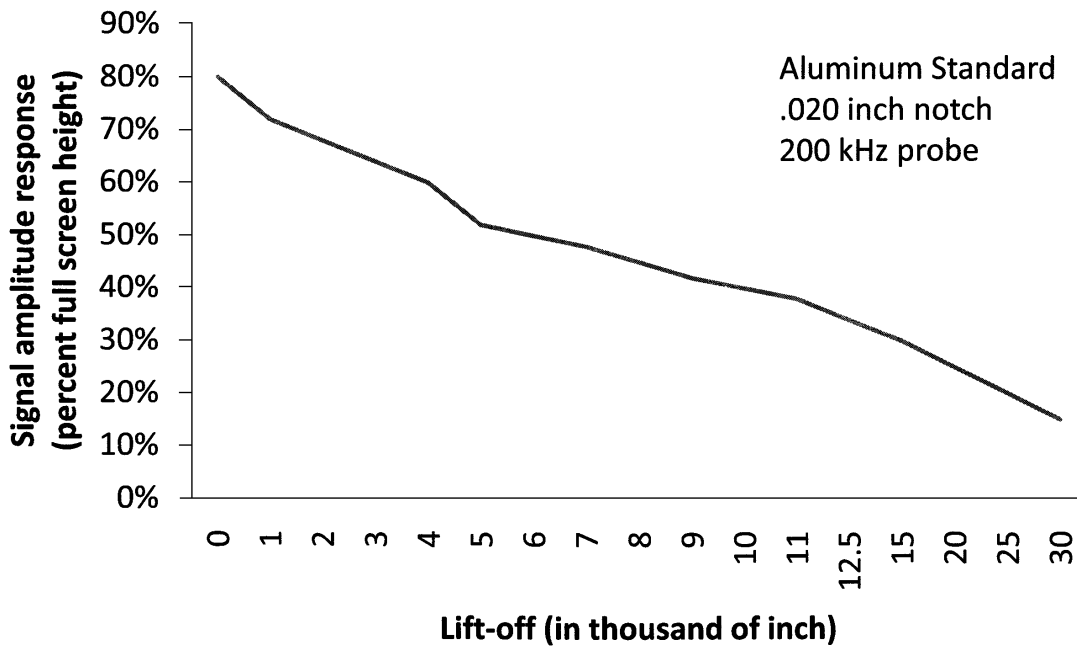
4.5.23.2 Phase Adjustment. In eddy current instruments with two-dimensional displays, the signals displayed can be rotated to align the direction of changes caused by the variable of no interest with the horizontal (or vertical, if so desired) axis. This is also called phase adjustment and its purpose is to position the response associated with lift-off variations in a direction that does not interfere with the interpretation of responses from variables of interest. The effectiveness of this technique increases as the phase difference between lift-off and the variable of interest increases from 0° to 90°.

4.5.23.3 Lift-Off Effects on Sensitivity. As lift-off increases, sensitivity of the eddy current system decreases. The magnitude of the response from a crack or other defect decreases continuously as the distance between the cracked metal and the probe increases. The typical effect of increasing lift-off on crack response is shown in [Figure 4-49](#).

4.5.23.4 Lift-Off Compensation Effects on Sensitivity. Lift-off must be minimized or compensated for to maintain a known level of sensitivity during an ET. A meter type of eddy current instrument requires some form of lift-off adjustment. Otherwise, slight variations in lift-off would provide strong signals which would completely mask the response from cracks. The magnitude of crack response is considerably reduced by lift-off compensation. The reduction in sensitivity depends upon the particular eddy current system in use. Each system must be set up for the particular application.

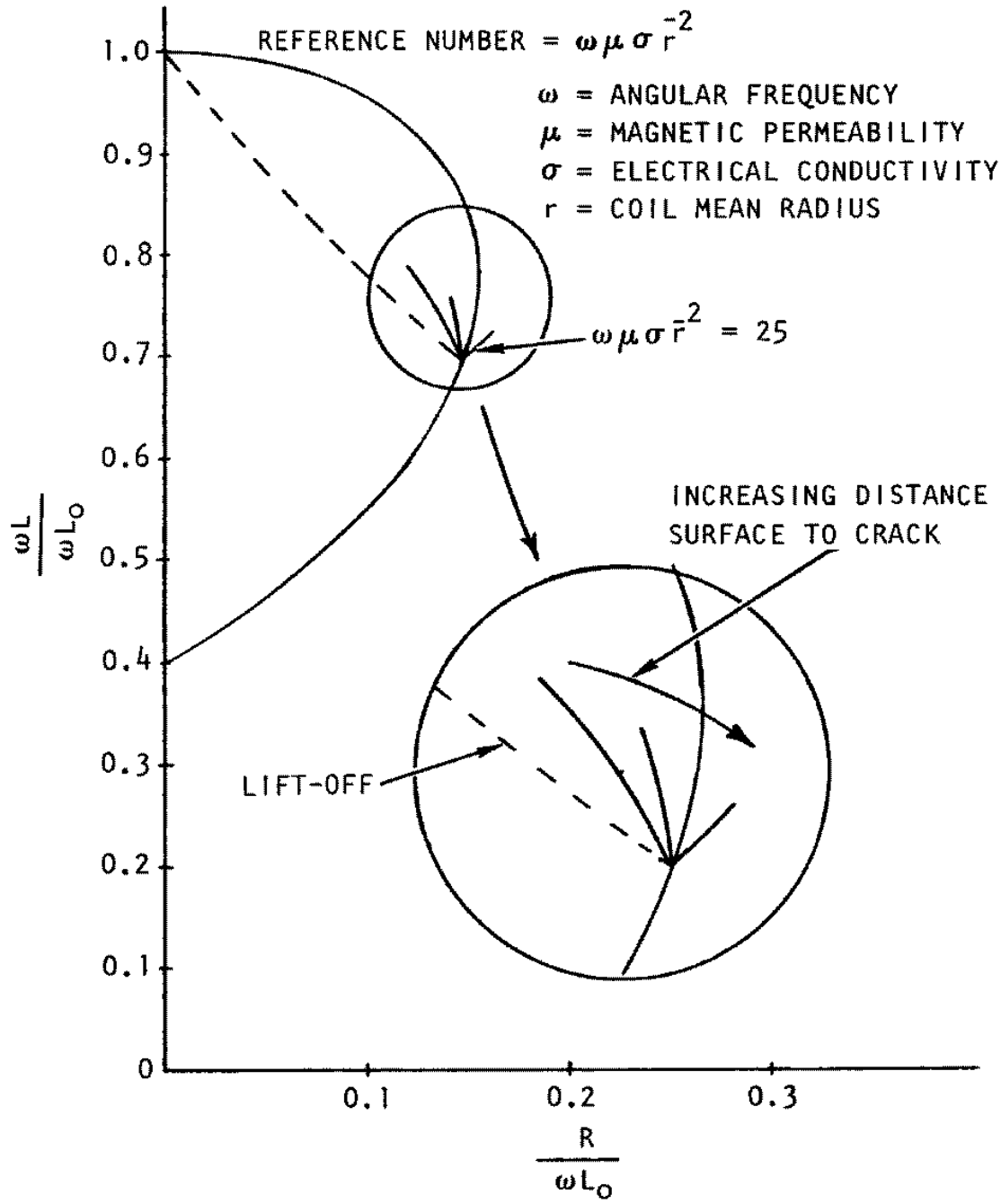
4.5.23.5 Phase Response from Cracks. Difference in phase between lift-off response and crack response is essential for the detection of cracks in most applications of ET. Depending on the crack indication on the impedance diagram, the phase angle between lift-off and crack response can be very small. This makes it very difficult to detect the difference between lift-off and probe motion from crack indications. Referring to [Figure 4-50](#), as lift-off increases and/or the frequency decreases, the impedance of the system approaches the air null point, the phase angle between lift-off and the conductivity line decreases. By maintaining a high fill-factor or low lift-off and operating at a high enough frequency, a crack indication (loss of conductivity) can be easily distinguished from lift-off signals because of the larger phase angle. These relationships, as seen on an impedance plane analysis eddy current instrument, are shown in [Figure 4-51](#) for aluminum, titanium and steel alloys. As crack depth increases, the phase angle approaches more closely the phase angle for conductivity changes.

Decrease in Crack Response with Increasing Lift-Off



H0404522

Figure 4-49. Decrease in Crack Response With Increasing Lift-Off



H0404521

Figure 4-50. Impedance Diagram Showing the Effect of a Crack

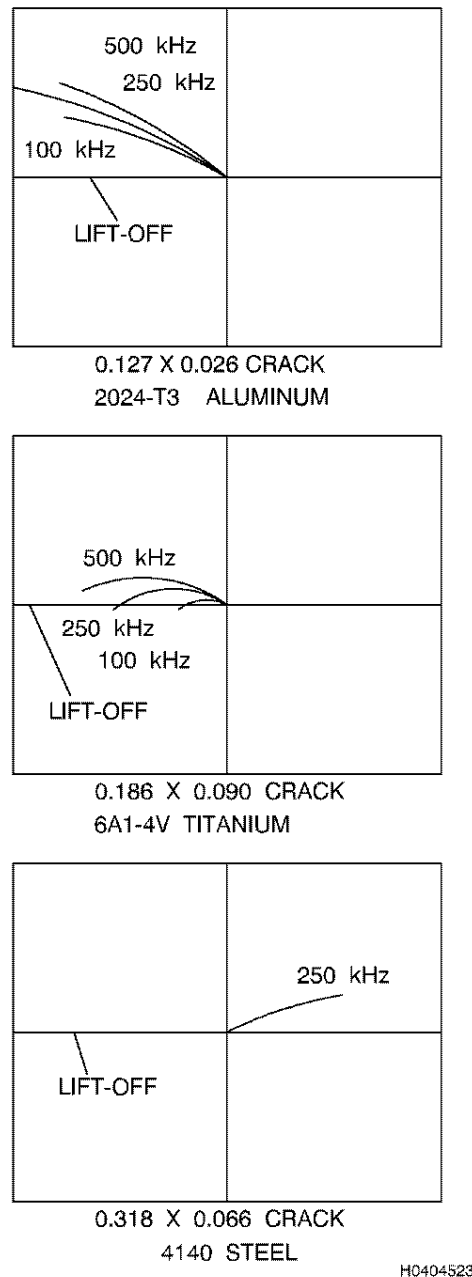


Figure 4-51. Phase Relationship Between Lift-Off and Crack Response for Various Materials and Frequencies

4.5.23.6 Ferromagnetic Materials. Variability in permeability can make eddy current inspection of ferromagnetic materials difficult. Permeability and lift-off have approximately the same direction of impedance change in unmagnetized ferromagnetic materials, but there can be very large variations in permeability that are very difficult to compensate. Magnetic saturation can be used to overcome the difficulties presented by permeability effects. In this technique, the material is magnetically saturated by a high DC magnetic field. This reduces the permeability to about 1 and makes it a constant. This results in a relatively low conductivity material, essentially non-ferromagnetic, for ET applications.

4.5.23.7 Phase Discrimination. Each of the variables (lift-off, conductivity, thickness, permeability, and flaws) has a characteristic effect on the net impedance of a coil. The display of the impedance curves caused by changes in the inspection variables can be of great assistance in determining the cause of a change.

4.5.23.8 **Probe Wobble.** In performing manual eddy current inspection with a surface probe or pencil probe, it is usually impossible to maintain the probe at the same angle, with respect to the inspection surface, as position is changed. In some instances, holders may be fabricated to guide the probe and hold the angular relationship with the inspection surface. The angular change between the probe and the inspection surface is termed probe wobble. Probe wobble results in changes in lift-off shown in [Figure 4-52](#). The amount of lift-off obtained because of changes in probe angle depends on the diameter and shape of the probe tip. Rounded tips of small diameter probes result in less lift-off than flat tipped probes with larger diameters. On impedance display instruments, lift-off effect can be lessened by changing the vertical to horizontal gain ratio.

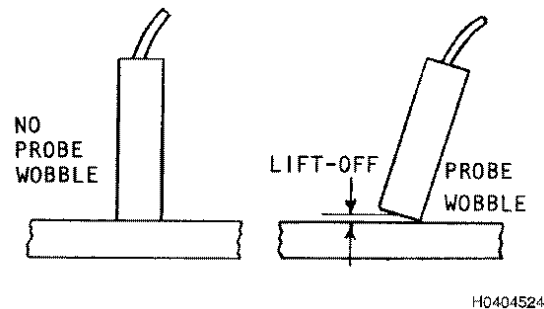


Figure 4-52. Lift-Off Resulting From Probe Wobble

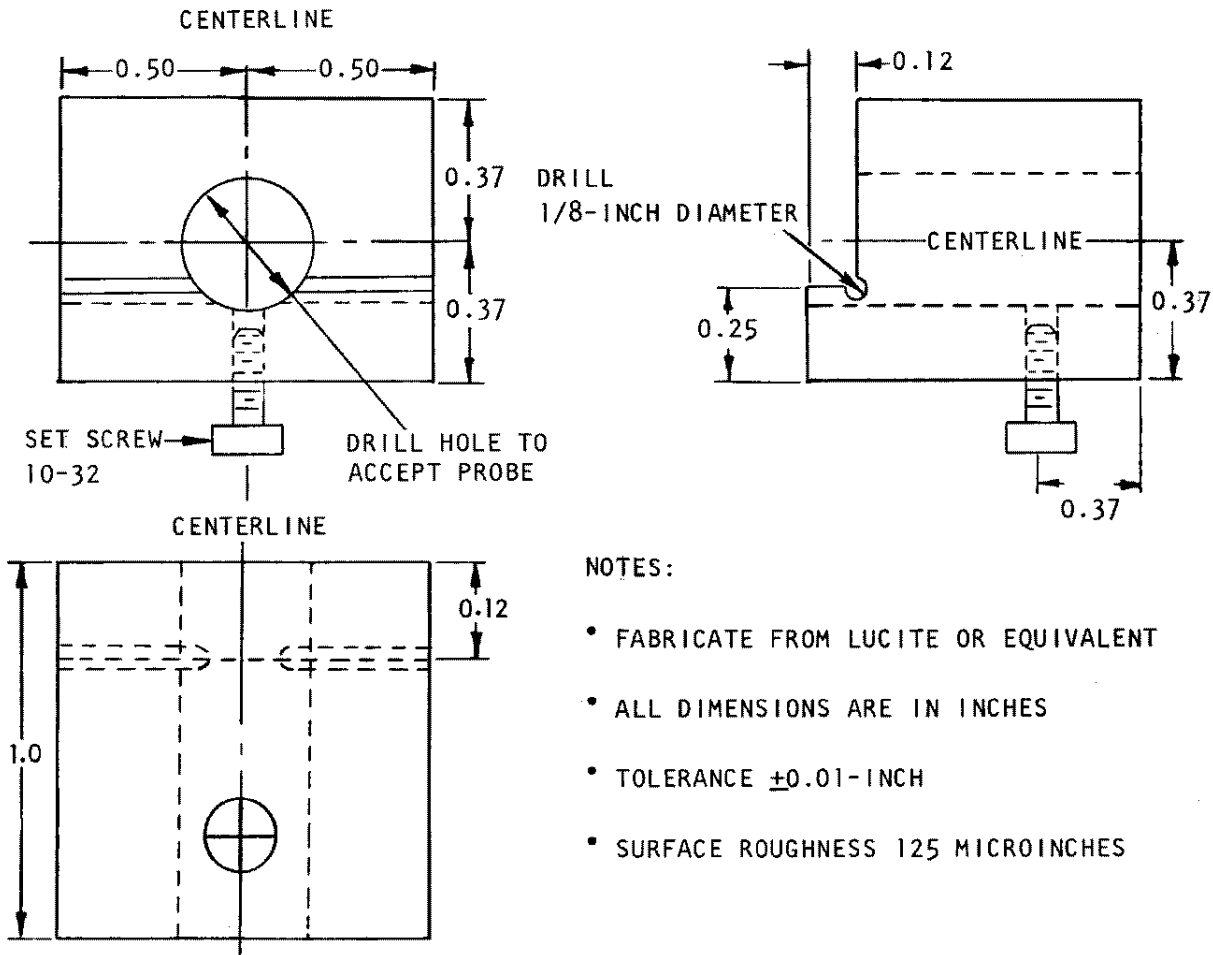
4.5.24 Effects of Crack Location on Detectability.

4.5.24.1 **Crack Location and Orientation.** Information on the history of cracks in specific inspection sites is very important. Time Compliance Technical Orders (TCTO) are often issued based on problems that have occurred on one or more aircraft systems. This means there is a known problem and inspections are necessary. Precise location of suspect cracks and their orientation produces more reliable inspections. Often, this information is provided from previous history of cracks in the designated locations. In other cases, such information may be determined from knowledge of stress distribution during service. Increasing definition of crack location and orientation permits the inspector to reduce his inspection time. For manual eddy current inspection, reduction in scanning time provides less operator fatigue and consequent improvement in inspection reliability.

4.5.24.2 **Cracks at Part Edges.** The edge of a part can be represented as an infinitely large crack and, consequently, produces a strong signal during eddy current inspection. The problem in inspecting part edges for cracks is separation of crack response from the strong edge response (edge effect). By fixing the distance of the probe from an edge, edge effect is minimized. Probe guides improve crack detection capabilities on edges.

4.5.24.3 **Inspection at Part Edges.** Two approaches can be used to inspect for cracks at part edges. The first method is to null the instrument with the probe at the edge of the part. Then, usually with a non-conductive fixture or some other method, the probe is maintained at the edge as it is scanned along the edge. If this position can be maintained, the inspection can be done with greater sensitivity than is possible with the same instrument and probe away from the edge. The second approach is to use a shielded probe, thus minimizing response from edges.

4.5.24.4 **Fixtures and Holders for Edge Inspection.** One of the simplest methods for eddy current inspection adjacent to a linear edge of a part is to tape or hold a straight edge at a predetermined distance from the edge. Nonmetallic straight edges SHOULD be used for this purpose. A simple fixture which can assist in positioning the probe adjacent to an edge is shown in [Figure 4-53](#). This fixture maintains the probe center 1/8-inch from the edge, but closer edge inspection can be obtained by varying the position of the drilled hole.



NOTES:

- FABRICATE FROM LUCITE OR EQUIVALENT
- ALL DIMENSIONS ARE IN INCHES
- TOLERANCE ± 0.01 -INCH
- SURFACE ROUGHNESS 125 MICROINCHES

H0404525

Figure 4-53. Edge Probe Guide

4.5.24.5 Curvature. When small diameter pencil probes are employed, curvature has minimal effect on crack response. This is due to the minimal lift-off effect of the small size of the probe tip. For most applications involving inspection of curved surfaces with small diameter pencil probes, flat standards can be satisfactorily used for curved surfaces in establishing sensitivity requirements.

4.5.24.6 Subsurface Flaw Detection. Increasingly, applications arise where it is desired to inspect for cracks initiating beneath an accessible surface. This could be a crack initiating on the opposite side of the accessible surface, in the structure contacting the opposite surface of an accessible surface, or beneath a conductive coating or plating. ET can be a powerful tool for the detection of subsurface flaws.

4.5.24.7 Impedance Plane Analysis of Subsurface Flaws. If the required frequency is used with impedance plane analysis instrumentation, eddy current penetration to the flaw area can be obtained. The phase and amplitude information received from the flaw can be directly related to the flaw depth.

4.5.24.8 Detection of Cracks under Metallic Coatings. The detection of cracks under metallic plating and coating is similar to detection of subsurface flaws. The magnitude of the total response consistently decreases with increasing coating thickness. With meter type instrumentation with a constant frequency test system, the thickness of plating or coating through which cracks can be detected decreases with increasing plating conductivity and magnetic permeability. In general, decreasing frequency permits detection of larger cracks under thicker coatings because of the increased depth of

penetration. Detection of cracks under metallic coatings with phase analysis instrumentation using the impedance plane diagram can be performed with more accuracy and sensitivity than with meter instruments because phase information can be measured. Recent research has shown that multi-frequency eddy current systems may find application for detecting and measuring cracks under metallic coatings.

4.5.25 Effects of Scanning Techniques on Detection.

4.5.25.1 Inspection Technique. Consistent positioning of the probe in relation to edges and interfaces during setup and scanning should be established to ensure maximum response from flaws with minimum interference from other sources of indications. If conditions are known to exist which may result in false indications or which could mask true indications from flaws, these conditions SHOULD be noted in the procedure and a means of interpreting or evaluating the false indications provided. In performing eddy current inspection of an area, the distance between scans or between measurements must be selected to ensure complete coverage for the minimum size flaw or variation in properties to be detected. In determining maximum distance between scans, consideration must be given to the change in magnitude of flaw response as the probe coil center position increases in distance from the center of the crack.

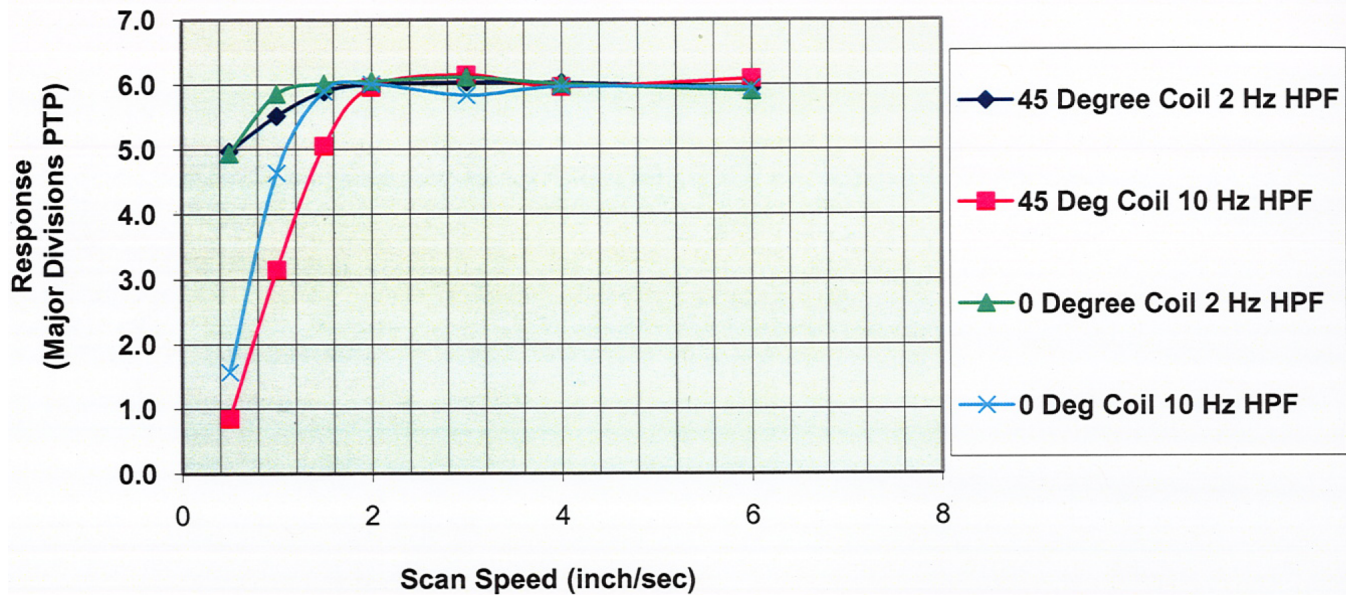
4.5.25.2 Scanning Speed. The scanning speed used in ET for cracks is related to the type of equipment and the inspection technique used. Slower scanning speeds are necessary when the inspector is required to interpret the readout while manually directing the probe in the specified scanning pattern. However, if the high pass filter (HPF) is used during the inspection process, consistent scanning speed is critical to ensure that the signal response received for a flaw is accurate. The HPF may diminish the signal response if the scanning speed is reduced during the evaluation process from the speed used during the initial standardization. The higher the HPF, the more dramatic the change in signal response when scan speed is reduced ([Figure 4-54](#)).

4.5.25.3 Scanning Pattern. The scanning pattern required for ET is based on the possible initiation site of the crack, the orientation of the cracks, and the size of the cracks which must be detected. If cracks initiate from an edge in thin material (0.050-inch or so), eddy current inspection is usually limited to a single scan of the edge. For thicker materials, scans might be required on both surfaces adjacent to the edge and one or more scans of the material between the edges. When cracks initiate beneath the heads of non-removable fasteners, the pattern usually consists of a single scan around the protruding head of the fastener to detect cracks growing outward from the hole. If cracks can occur at a variety of positions and orientations, as is possible on flat surfaces, in radii, and on cylindrical surfaces, scanning must be performed in a manner which will assure detection of the smallest cracks required to be found. For these types of inspection areas, the direction of scanning, the number of scans, and the distance between scans SHOULD be specified.

4.5.25.4 Automatic or Semi-Automatic Equipment. Automatic eddy current equipment in conjunction with high speed recorders is capable of operation at extremely high speeds. The upper limits of scanning speed are based on the operating frequency and the sampling rates of the recorder or readout. The principal use for automated eddy current equipment by the military is for the inspection of bolt holes. In this application, rotational speeds of 40-3000 rpm can be obtained by the inspection system.

4.5.25.5 Use of Recorders or Digital Displays. The use of recorders or digital displays (LCD type eddy current instruments) permits increasing the speed of manual scanning to the limits imposed by the reaction time of these instruments. Generally, other restrictions related to guiding the probe in the prescribed scanning pattern become the controlling factor when recorders or digital displays are used.

Effects of HPF and Scan Speed on Signal Response



H0404526

Figure 4-54. Effect of Scanning Speed on Response from a Crack Using Ribbon Coils

4.5.26 Reference Standards for Cracks.

CAUTION

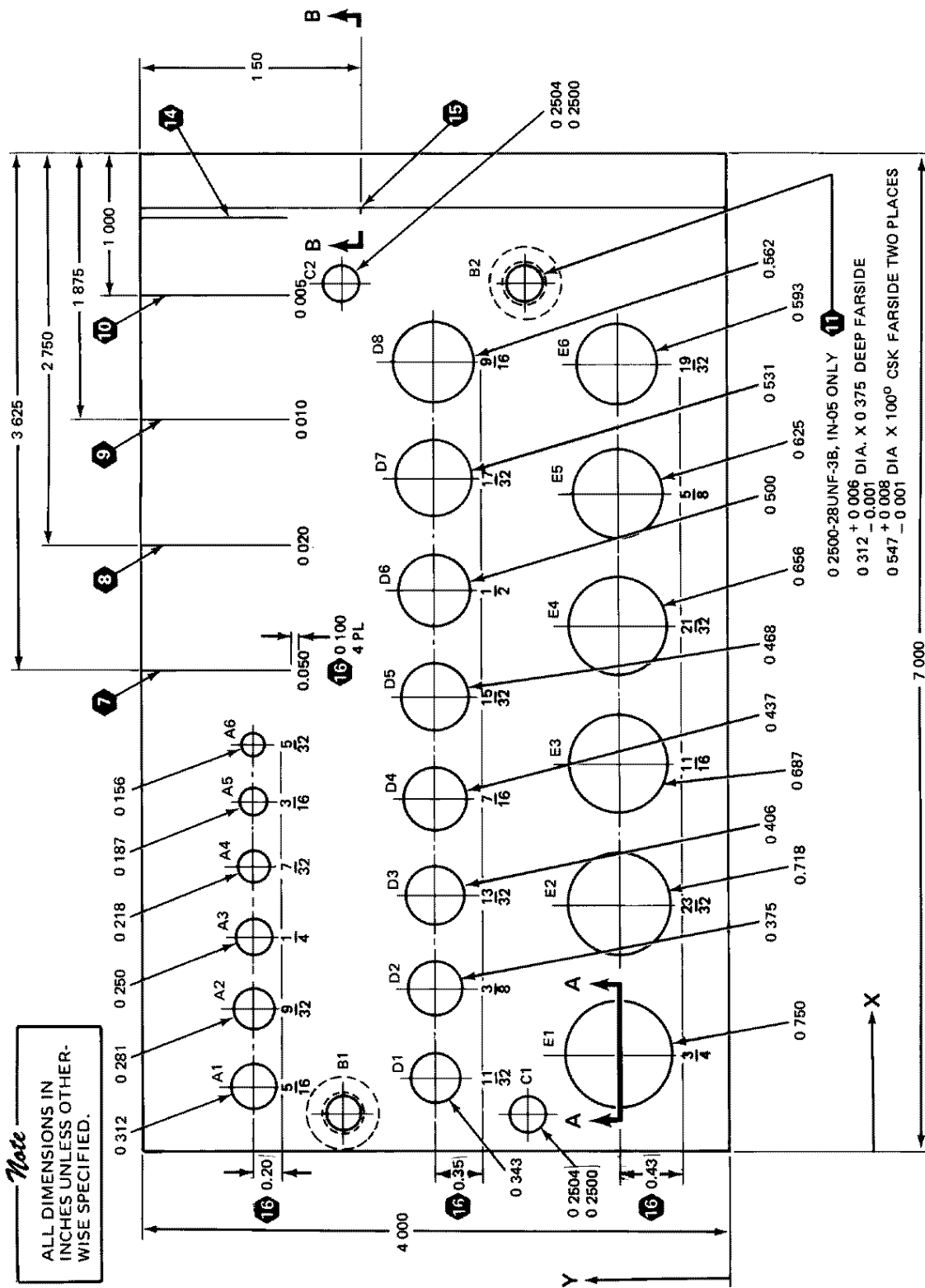
Steel general purpose eddy current reference standards, like most ferromagnetic material, is susceptible to corrosion if not correctly stored. Corrosion less than 0.010" (Pitting Depth) does not affect the serviceability of the standard and may be treated using a scuff pad (e.g., scotch-brite or equivalent) to remove surface corrosion. Steel standards with corrosion greater than 0.010" (Pitting Depth) are unserviceable and must be replaced prior to further use. The steel standard must be coated with light oil and protected from the elements (e.g., plastic bag, plastic case, etc.) when not in use.

There are several different materials undergoing inspection within the Department of Defense. An inspector will find two primary general purpose eddy current standards for aluminum in the field: the Air Force standard, NSN 6635-01-092-5129, P/N 7947479-10 (aluminum) and the Navy standard, PN NRK-3A (aluminum). The aluminum Navy standard has a higher conductivity bottom plate. The Navy also has a kit consisting of three standards of the same geometric configuration, each of a different material (kit PN NRK-3AST, NSN 5280-01-352-1336). This kit consists of:

- One aluminum standard, P/N: NRK-3A or NRK-3AL, is made of 7075-T651 top & middle layers and a 7075-T73 bottom layer
- One steel standard, P/N: NRK-3S or NRK-3ST, is made of 4340 alloy on all three layers
- One titanium standard, P/N: NRK-3T or NRK-3TI, is made of 6AL4V, is alloy on all three layers

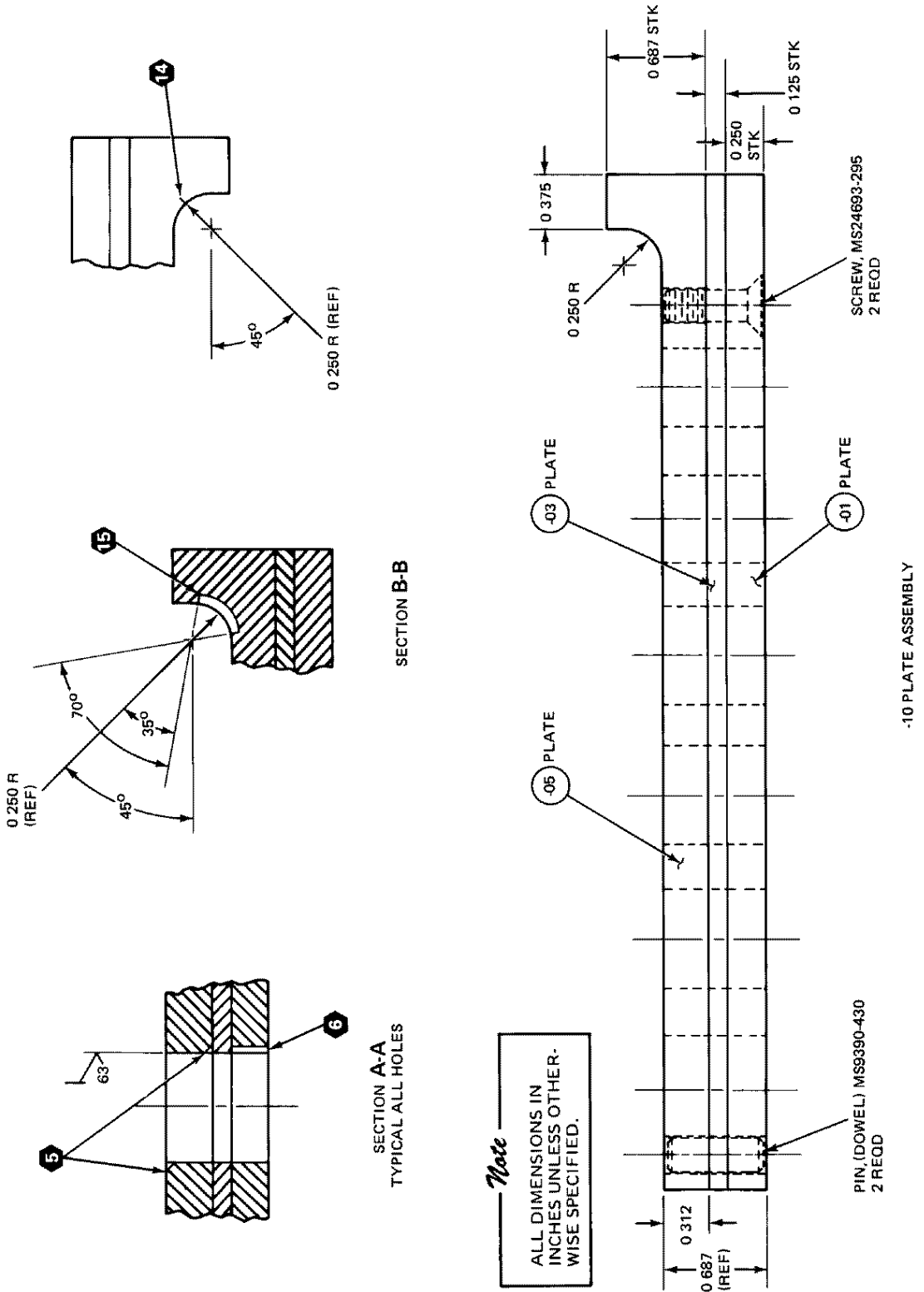
NOTE

Unless otherwise specified by the weapon system engineering authority, the Air Force general purpose eddy current standard ([Figure 4-55 \(Sheet 1\)](#) through [Figure 4-55 \(Sheet 3\)](#)) SHALL be the common standard used to perform ET's on aluminum components within the Air Force. The standard made to the Navy configuration ([Figure 4-56](#)) may be used as a substitute for the Air Force general purpose eddy current standard. When using the Navy standard, calibrate on the long EDM notches for surface inspections and the corner notches in the upper layers for bolt hole inspections unless otherwise directed by a part specific procedure.



H0404527

Figure 4-55. Air Force General Purpose Eddy Current Standard (Sheet 1 of 3)



H0404528

Figure 4-55. Air Force General Purpose Eddy Current Standard (Sheet 2)

DRILLING LEGEND

QUANTITY REQUIRED		HOLE DIAMETER		POSITION		HOLE SYMBOL									
X	Y	X	Y	A	B	C	D	E	F	G	H				
0.437	3.250	A1													
0.983	3.250	A2													
1.498	3.250	A3													
1.982	3.250	A4													
2.435	3.250	A5													
2.856	3.250	A6													
0.250	2.625		B1												
6.094	1.375		B2												
0.250	1.375				C1										
6.094	2.625				C2										
0.500	2.000						D1								
1.125	2.000						D2								
1.781	2.000						D3								
2.468	2.000						D4								
3.186	2.000						D5								
3.936	2.000						D6								
4.717	2.000						D7								
5.529	2.000						D8								
0.687	0.750							E1							
1.718	0.750							E2							
2.718	0.750							E3							
3.686	0.750							E4							
4.623	0.750							E5							
5.529	0.750							E6							

PARTS LIST

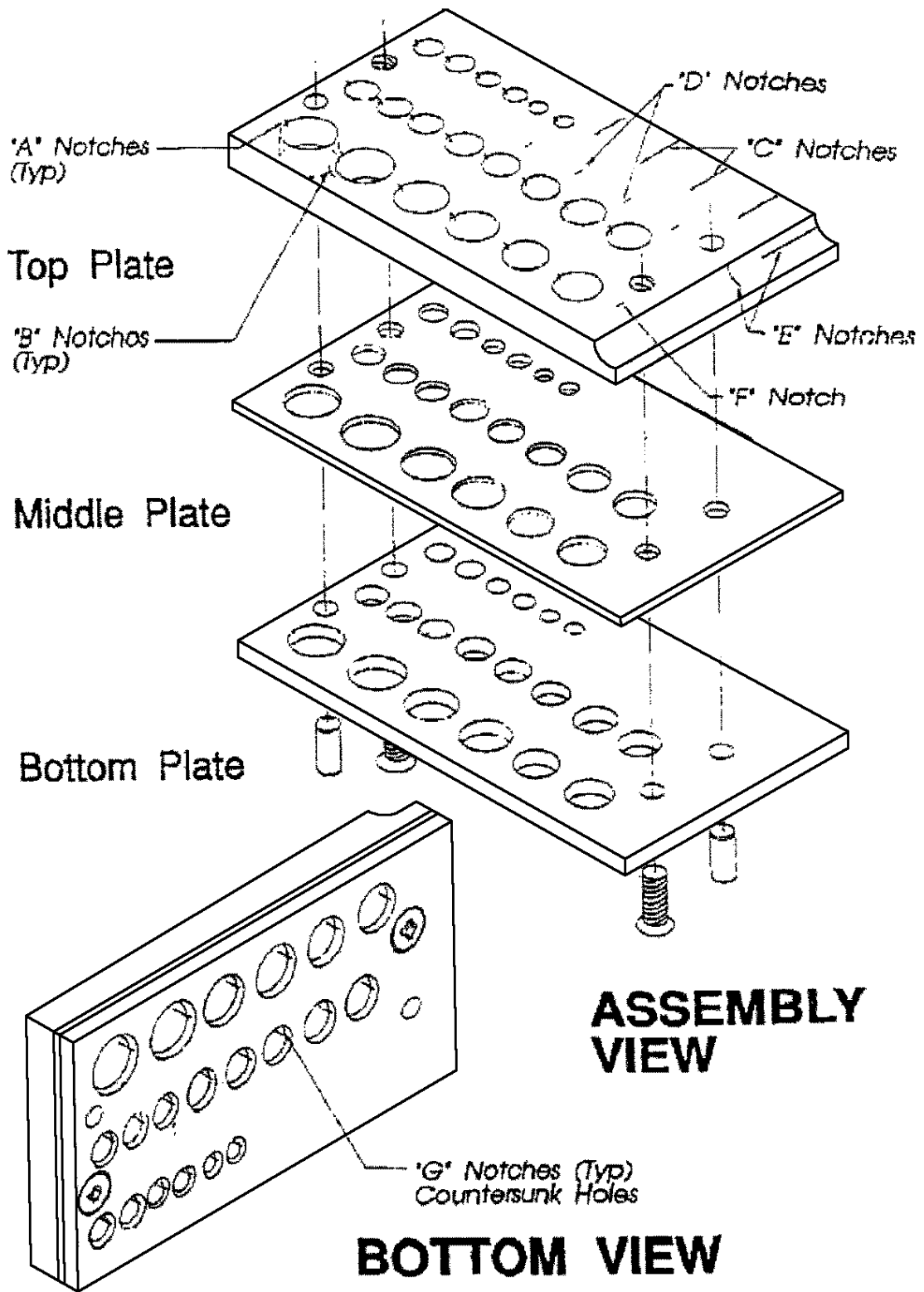
QTY	NOMENCLATURE	PART NO.	MATERIAL/SPECIFICATION
2	SCREW	MS24693-295	
2	PIN	MS9390-430	
1	PLATE	-05	AL ALY PL 0.687 THK QQ-A-250/12. CMPNSN 7075, COND TN T6
1	PLATE	-03	AL ALY SH 0.125 THK QQ-A-250/12 CMPNSN 7075, COND TN T6
1	PLATE	-01	AL ALY PL 0.250 THK QQ-A-250/12 CMPNSN 7075, COND TN T6
	PLATE ASSY	-10	

Note

- 1 INTERPRET THIS DRAWING PER MIL-STD-100
2. IDENTIFY PART PER MIL-STD-130
3. BREAK SHARP EDGES EXCEPT AT HOLES AND REMOVE BURRS
- 4 FINISH ANODIZE AL ALY PARTS PER MIL-A-8625, TYPE II, CLASS I
- 5 ELOX SLOT, 0.030 X 0.030 X 0.004 ± 0.001.
- 6 ELOX SLOT, 0.020 X 0.250 X 0.004 ± 0.001
- 7 ELOX SLOT, 0.050 X 1.000 X 0.004 ± 0.001
- 8 ELOX SLOT, 0.020 X 1.000 X 0.004 ± 0.001
- 9 ELOX SLOT, 0.010 X 1.000 X 0.004 ± 0.001
- 10 ELOX SLOT, 0.005 X 1.000 X 0.004 ± 0.001
- 11 THREADS PER MIL-S-7742
12. SURFACE ROUGHNESS $\sqrt{63}$ MAX ALL OVER PER ANSI B46 1-1978
- 13 THE EDDY CURRENT METHOD IS USED TO DETECT CRITICAL CRACKS ORIGINATING IN HOLES OF LOWER WING SKIN OF ALL AIRCRAFT
- 14 ELOX SLOT, TAPERED 0.200 AT EDGE CORNER TO 0.000 X 1.000 X 0.004 ± 0.001
- 15 ELOX SLOT, 0.050 DEEP X 0.004 ± 0.001 AND PERPENDICULAR TO THE RADIUS
- 16 MECHANICAL ETCH NUMBERS 0.093 HIGH AS SHOWN.
- 17 ALL DIMENSIONS IN INCHES UNLESS OTHERWISE SPECIFIED

H0404530

Figure 4-55. Air Force General Purpose Eddy Current Standard (Sheet 3)



H0404531

Figure 4-56. Navy Eddy Current Reference Standard (Sheet 1 of 2)

P/N NRK-3AST

Contents:

- (1) 7075-T651 top and middle layers, 7075-T73 bottom layer P/N NRK-3A
- (1) 4340 Steel P/N NRK-3S
- (1) 6AL4V Titanium P/N NRK-3T

Mounted In a Hi-Impact, Waterproof Plastic Case

EDM Notch Location & Size

"A" Notches: .030" x .030" corner notch in each of 20 holes on surface of top plate.

"B" Notches: .030" x .030" corner notch in each of 20 holes on bottom surface of top plate.

"C" Notches: .750" long surface notches; .005", .020", .050" deep.

"D" Notches: .100" long surface notches; .005", .020", .050" deep.

"E" Notches: 1 each transverse radius notch .050" deep & 1 each longitudinal radius notch one inch long and tapered from .050" deep at edge to .000" at inboard edge of notch.

"F" Notches: .030" long notch, .010" deep.

"G" Notches: .250" long notch, .020" deep in 20 countersink holes.

All notches are certified at .004" +/- .001" width.

H1211408

Figure 4-56. Navy Eddy Current Reference Standard (Sheet 2)

4.5.26.1 Cracks as Reference Standards. When an eddy current instrument is setup for detection of cracks, some means must be provided to assure that the sensitivity of the test system is sufficient to detect the smallest required crack size. Ideally, the best standard would be a section of the same material containing a crack of this minimum size. Cracks of specified sizes are difficult to obtain. With few specimens to choose from, such situations are rare. Fatigue cracks of specified size can be grown under laboratory conditions, but this method is extremely expensive. The length of the crack along the surface and its width at the surface is easily measurable. The depth of the crack is generally unknown and must be approximated from other data. Because of difficulty in obtaining actual cracks for reference standards, a number of other standards may be used. These standards are discussed below.

4.5.26.2 Requirements for Reference Standards. The primary requirement for eddy current reference standards is they provide uniformity of response which can be correlated to the condition or material property to be detected or measured. Two fundamental ideas are assumed by uniformity of response. First, this means all tests can be done with the same sensitivity or that different levels of sensitivity can be compared on a quantitative basis. Second, standards fabricated to a specific design should be stable devices able to provide a repeatable response within certain specified limits. To be useful for flaw size and type evaluation, the reference standard must relate to the flaw to be detected. By means of correlation data, prior history or investigation, the response from the reference standard must relate to the response from the condition or material property of the part. To permit fabrication of standards at a number of locations, material, alloy, temper and dimensional tolerances which will provide the required response should be defined in the applicable technical order for the test being performed. Methods of fabrication which use simple tools SHOULD be specified when adequate uniformity and sensitivity can be obtained. Ideally, when an instrument has been adjusted for a specified response from the standard, a signal of approximately the same amplitude and phase (where applicable) should be obtained from the condition or material property with an eddy current instrument and probe of the same general type.

4.5.26.3 Standards for Specific Tests. Standards must be designed for the specific material property or condition being tested. Specific standards are required for each type of test being performed. Calibration standards used to sort alloys must meet very specific conductivity requirements. Calibration standards for measuring coating thickness of conductive coatings would not be suitable for measuring coating thickness of paint or other nonconductive coatings or for detecting cracks around rivet holes. Drilled holes or EDM (electro-discharge-machining) notches in an aluminum block should not be used to test for material thickness or alloy composition of titanium or stainless steel parts.

4.5.26.4 Artificial Defects for Standards. Due to the difficulty of obtaining the types and sizes of real flaws in parts for use as reference standards; a variety of artificial flaws have been developed to simulate the real flaws. Fatigue cracks have been grown under laboratory conditions, but reproducible sizes in sufficient quantity for standards are impractical. Artificial flaws, such as drilled holes, EDM notches, saw cuts, two surfaces clamped together to simulate a crack, or chemically produced conditions to simulate pits or corrosion, can be produced in a variety of ways. Ideally an artificial flaw will produce an eddy current response identical to the response from a real flaw of the same size, orientation, and location. This ideal is seldom achieved with artificial flaws. Estimation of flaw size from the response to artificial flaws must be based upon correlating previous known flaw sizes with the response from the artificial flaws. To maintain the quality of this correlation, it is necessary to carefully specify the material properties and fabrication process of the artificial defect standard.

4.5.26.5 Simulated Conditions for Standards. When using eddy current techniques to measure conductivity, coating thickness, permeability, alloy sorting, and hardness, standards can usually be obtained which represent the materials and conditions being tested. These calibration standards are used for direct comparison to the response seen on the part being tested. Great care must be exercised in handling these types of calibration standards. Scratches, dents, distortion, oxidation, or other conditions can alter the calibration standards making them useless for comparison and calibration purposes. The primary standards are usually maintained under laboratory storage conditions, and may be traceable to the National Institute for Standards and Technology (NIST). The secondary standard, is compared to the primary standard for response; the secondary standards are said to be traceable to the primary standard. The actual testing in the field environment use the secondary (or tertiary) standards and the standards are periodically compared to the primary standard to assure integrity.

4.5.26.6 EDM Notches. Electrically discharge machined (EDM) notches, in a variety of sizes, shapes and locations, can be placed in almost all metals. The width of the notch can be held to as small as 0.003-inch, and although far greater in width than most cracks, this method provides a narrower slot, or notch, than all other fabricating techniques such as saw cuts. Similar responses are obtained on real cracks.

4.5.26.7 EDM Notches in Ferromagnetic Steel. The eddy current signal does not penetrate well in ferromagnetic materials because of the shielding effect of the high magnetic permeability. EDM notches are useful as examples of flaws open to the surface of a part. Surface breaking cracks are best detected by using a very high frequency (500 kHz and greater) which

is not meant to penetrate deeply into the part. Under these conditions the test provides very high sensitivity to surface flaws in ferromagnetic materials. Likewise the test provides little if any information on flaw depth.

4.5.26.8 Saw Notches. Probably the simplest method of preparing eddy current standards is by means of a jeweler's saw. With a 7/0 blade, notches as narrow as 0.007 to 0.008-inch can be made in the edge of a standard. Circular jeweler's slotting saws are also available for other notch locations. Phase response is similar to that obtained from cracks. However, as notch width increases, the similarity to a crack decreases.

4.5.26.9 Machined Notches. Standards with machined notches can be used under some test conditions. However, the response of a particular probe size and frequency to the notch must be evaluated for its applicability to a test situation.

4.5.26.10 Choosing Reference Standards for Cracks. As previously discussed, the primary requirement for eddy current reference standards is they provide uniformity of response that can be related to the minimum size crack to be detected. To various degrees, several types of reference standards may meet this criterion. Consequently, such factors as cost, ease of fabrication, availability, and field application become prime considerations.

4.5.27 Thickness Measurement.

4.5.27.1 Criteria for Application.

4.5.27.2 Types of Measurements. In general, three types of thickness measurements may be performed by eddy current techniques. The total thickness of thin metallic products, such as foil, strips and sheets, may be determined when the thickness dimension is less than the effective depth of penetration of eddy currents in the material. A second category of thickness measurement includes the measurement of metallic plating or coating on a conductive or magnetic base. Subcategories of plating and coating measurements can be established on the basis of the relative conductivity or permeability of the plating and the base metal on which it is plated. Typical subcategories of plating measurements include the following:

- Low conductivity plating on high conductivity base
- High conductivity plating on low conductivity base
- Low permeability plating on a high permeability base
- High permeability plating on a low permeability base

4.5.27.3 The terms high and low are relative and are not meant to indicate specific values. The third category of measurement is the determination of nonconductive coating thickness on a metallic base. This application can also be extended to measure the total thickness of thin nonconductive materials that are accessible from both sides, by holding a block of metal against the surface opposite the probe.

4.5.27.4 General Limitations of Plating Thickness Measurement. The use of eddy current techniques for thickness measurement is confined to thin materials. This limitation results from the inability of the eddy current field to penetrate deeply into conductive materials. The effective depth of penetration, and therefore the thickness that can be measured, decreases as the conductivity and/or permeability of the metal increases. To determine the thickness of plating or coatings on metallic substrates, a difference must exist in conductivity or permeability between the surface material and base material. Increased sensitivity is obtained, as the differences between plating and substrate conductivity or permeability become larger. For nonconductive coatings, the sensitivity improves with increasing frequency. Larger probe diameters provide greater sensitivity for measurement of thicker plating. A summary of the effects of an increase in material properties and inspection variables on the sensitivity and range of thickness measurements is presented in [Table 4-8](#) in [Paragraph 4.8](#).

4.5.27.5 Test Systems. A wide variety of specialized equipment is manufactured for thickness measurement. Many such instruments are optimized for one or two types of applications. Examples include instruments designed to measure nonconductive coatings on nonmagnetic metals or instruments for measuring nonmagnetic plating on a magnetic substrate. Because of limited requirements, such specialized equipment is usually not available for use in the field. In most cases, general purpose instruments may be adapted for thickness measurement. Many of the meter type instruments can be used for a wide variety of thickness measurement operations. Impedance plane analysis equipment is very useful for thickness measurement. Phase change is nearly linear with increasing depth of penetration, thereby providing more consistent sensitivity and accuracy over the entire range of measurement.

4.5.27.6 Thickness Measuring Procedures. Before thickness measurement can be performed, the eddy current measurement procedures SHALL be carefully established and proven to ensure accuracy and reliability. Curves SHOULD be prepared to relate instrument readings to known thickness standards. A sufficient number of samples within the thickness range to be measured must be used in preparing the curves to ensure that a smoothly increasing or decreasing curve will be obtained. The type and number of standards necessary for instrument standardization SHALL be defined. The limitations of the procedures in terms of material and dimension applicability SHALL be established and noted in the procedures.

4.5.28 Measurement of Total Metal Thickness.

4.5.28.1 Applications of Total Thickness Measurement. The primary use of eddy current techniques for measuring the total thickness of metal parts is to detect corrosion on the far sides, or between layers of structure. However, this technique can also be used to establish the thickness of a thin sheet, to determine wear or thinning of sheet materials, and to measure thickness, erosion, or corrosion of tubing walls. Thickness measurement with ET is generally used when:

- calipers or other mechanical measurement is impractical
- ultrasonic equipment is not available
- if very thin materials are to be measured

4.5.28.2 Total Thickness Limitations. The accuracy and range of metal thickness measured with ET are dependent upon the electromagnetic properties of the material and the test system. Increasing conductivity and magnetic permeability increase accuracy in measuring very thin specimens, but decrease the effective range of measurement and the accuracy at greater depths. Therefore, at a specified frequency, you can measure thicker metals that have low conductivity and/or low magnetic permeability compared to metals that have high conductivity and/or high permeability.

4.5.28.3 Frequency Effects in Total Thickness Measurement. Just as decreasing frequency increases the depth of penetration of eddy currents in a conductor, decreasing frequency also increases the thickness of a metal that can be measured by ET techniques. Higher sensitivity is obtained for the thinnest specimens with a higher frequency. For thicknesses (over 0.050-inch), the lower frequency provides greater sensitivity and greater overall penetration. Sensitivity in any thickness range can be determined by slope of the plotted thickness line: the greater the slope (ordinate over the abscissa) the better the sensitivity. Optimum frequency can be estimated by using the formula for one standard depth of penetration.

4.5.28.4 Effects of Probe Construction. Probes designed specifically for thickness measurement have air cores, and are generally larger in diameter than the ferrite core probes used for flaw detection. Larger diameter probes average thickness measurements over a larger area. Smaller diameter probes, and probes with ferrite cores, reduce the area of measurement, and therefore can be used in smaller areas and closer to edges. The larger air core probes can provide greater sensitivity for thickness measurements than the ferrite core pencil probes.

4.5.28.5 Operating Procedures for Total Thickness Measurement. All thickness measuring SHOULD be performed in accordance with pre-established procedures. In general, these procedures will include the following steps:

- a. Prepare part for thickness measurement.
- b. Establish the presence of geometrical factors, which will limit or restrict thickness measurement.
- c. Select appropriate test system, probe, and operating frequency.
- d. Develop or verify a calibration curve by using either NIST traceable calibration standards or using known thickness reference standards to setup the test system.
- e. Perform thickness measurements at designated points.
- f. Record thickness and report all rejectable values as required by the written procedure.

NOTE

When measuring thickness using ET, ensure the probe and the part being measured are kept far enough away from any other metal that the eddy currents are not affected. Metal standards on metallic table tops should be avoided because of conductive interference.

4.5.28.6 Prepare Part for Thickness Measurement. Many thickness measurements must be performed through nonconductive coatings such as paint or anodic coatings. Lift-off compensation must be used during the calibration. Any loose foreign material **SHOULD** be removed from the surface where thickness is being determined. Any sharp edges, protrusions, or chemicals that are potentially damaging to the probe **SHOULD** be removed.

4.5.28.7 Presence of Geometrical Limitations. Prior to measuring thickness by eddy current techniques, the presence and position of any structural features that could restrict accessibility or reduce accuracy of measurement must be established. Thickness measurement must be performed sufficiently far away from fastener and other conductive objects to prevent its influencing the meter reading. Limited access may restrict the type of probe to be used. In most cases, written inspection procedures will define geometrical limitations.

4.5.28.8 Selection of Test System. The test system selected for thickness measuring must be based on thickness measuring requirements, frequency of the eddy current instrument, and the types of probes available.

4.5.28.9 Selection of Test Frequency for Thickness Measurement. For each thickness measurement task to be performed by eddy current techniques there is an optimum frequency or range of frequencies that will provide optimum sensitivity at the depth to be measured. The product of the material conductivity in percent IACS and the relative magnetic permeability is plotted along the vertical axis, and frequency in kilohertz is plotted along the horizontal axis. Lines representing optimum thicknesses are plotted on the graph. To determine the recommended frequency, the product of material conductivity and relative permeability of the material to be measured is found on the vertical axis. Follow this point horizontally to the diagonal line representing the thickness to be measured. The recommended frequency is found on the horizontal axis by extending a line vertically downward from the established point. Considerable variation from this frequency value will still provide sufficient sensitivity for most applications. When in doubt, the adequacy of a frequency may be determined by establishing a trial calibration curve.

4.5.28.10 Instrument Setup. Because the general-purpose instruments are not specifically designed for thickness measuring, correlation must be established between instrument readings and thickness dimensions. Therefore, the thickness ranges over which measurements are to be performed **SHOULD** be defined as closely as possible to minimize the number of data points to be established. Where applicable, lift-off compensation should be used to minimize the effects of variations in surface finish on thickness readings.

4.5.28.11 Record Thickness and Report Rejectable Values. Most written procedures provide acceptance limits for the thickness dimension. When a rejectable value is obtained, it is advisable to recheck the instrument using the reference or calibration standards. The written procedure usually provides methods for reporting rejectable values.

4.5.28.12 Standards for Total Thickness Measurement. The standards used for setup for thickness measurement must have the same electrical conductivity, magnetic permeability, and geometry as the material being measured. The same electrical conductivity is usually obtained by requiring the standards to be fabricated from the same alloy and temper as the inspection material. In magnetic materials, permeability can vary to such a degree within a single alloy and temper that selection of representative standards can be difficult. The high permeability of iron and ferromagnetic steel restricts the use of eddy current thickness measurement to very thin metals. The curvature of the standards **SHOULD** be the same as the part being inspected. All standards **SHOULD** be uniform in thickness and the accuracy of the standard thickness **SHOULD** be at least 10 times that required for the accuracy of the thickness measurement. For example if thickness measurement is required to the nearest 0.001-inch, the standards **SHOULD** be accurate to the nearest 0.0001-inch. All standards **SHOULD** be clearly identified with alloy, temper and thickness.

4.5.28.13 Accuracy of Thickness Measurement. The accuracy obtained in metal thickness measurement varies widely depending on material properties, thickness, frequencies used, and system noise level. With higher frequencies (500 kHz and up) on thin materials (0-010-inch and less), thicknesses may be measured to the nearest 0.0001-inch. As frequencies are lowered and thicknesses increase, accuracy decreases. For maximum accuracy, variations in lift-off, conductivity, geometry and magnetic permeability must be reduced to the lowest possible level.

4.5.29 Application of Conductive Coating Measurement. ET techniques are commonly used to measure the thickness of conductive plating on metallic materials. These measurements may be used as a process control to determine the proper thickness of plating or conductive coatings has been applied to a substrate. The thinning of such plating and coatings, because of erosion or corrosion, can also be established. ET is sometimes used to determine the presence and thickness of surface layers which have been altered in composition from the metal deeper within the part. This application includes the measurement of carburized cases in steel and the depth of oxygen or hydrogen contamination of the surface layers of titanium alloys. The absorption of carbon into the surface layers of steel effectively lowers the magnetic permeability. The solution of hydrogen and oxygen in the surface of the titanium alloy lowers the conductivity of the surface. The amount of surface contamination can be measured by measuring the changes in permeability and conductivity.

4.5.29.1 Effect of Material Properties on Plating Thickness Measurements. Although the depth of penetration of eddy currents in metals decreases with increasing electrical conductivity, lack of penetration for measuring plating thickness is seldom a problem. Plating and coating thicknesses rarely exceed 0.005-0.010-inch and in many instances are less than 0.003-inch thick. The sensitivity of inspection is controlled to a large measure by the difference in conductivity and/or magnetic permeability between the base metal and the plating. Coating or plating thickness measurement is considered feasible if the product of conductivity and permeability for the base metal and the coating have a ratio of 1.5 or greater or 0.67 or less. Sensitivity increases as the difference in the conductivity or permeability value between coating and substrate increases. Therefore, a rough determination of sensitivity can be obtained from an impedance curve, which shows the positions of substrates and coating at the frequency and probe size used for inspection.

4.5.29.2 Effect of Test Conditions on Plating Thickness Measurement. Normally, the frequencies used for plating thickness measurement are relatively high, 100 kHz and greater in specialized equipment; frequencies as high as 6 MHz are available. These frequencies provide high sensitivities for very thin coatings. As the conductivity differences between plating and base metal decrease, the frequency may be either increased or decreased as necessary to obtain equivalent sensitivity for the thickness to be measured. Considerable latitude from these approximate values may be exercised in choosing the actual operating frequency. If doubt exists, a trial calibration curve should be prepared. To reduce the effects of surface roughness and variations in nonconductive coatings, lift-off compensation (intermediate layer technique) SHOULD be used. Generally, 0.002 to 0.003-inch lift-off compensation is sufficient unless very rough surfaces are present in the test area. An increase in probe diameter and the use of air cores rather than ferrite cores has the effect of increasing measuring sensitivity and extending the depth to which accurate plating thickness measurement can be performed.

4.5.29.3 Procedures for Plating Thickness Measurement. An approved written procedure is required for each application of ET techniques for plating thickness measurement. Each procedure SHOULD include the following steps:

- a. Define the objective of the plating or coating thickness measurement. The type of base metal and plating SHOULD be included in the procedure.
- b. Clean any foreign material from the inspection area. Even though lift-off compensation is used, excessive build-up of foreign material in excess of lift-off adjustment could lead to significant errors.
- c. Select the test system, instrumentation, and probe that will perform the thickness measurement to the required accuracy.
- d. Develop or verify calibration curve, and standardize the test system using the specified standards. A calibration curve must be available for each combination of instrument and probe.
- e. Perform plating thickness measurements at the designated points. At least three readings SHOULD be taken at each measurement position to ensure accurate and repeatable values. The probe should be held against the part with constant pressure (when available, spring loaded probes can be used to aid in maintaining constant pressure). For curved surfaces, a fixture may be used to maintain the probe normal to the surface. Plating thickness measurements SHOULD be made in areas where the readings are not affected by adjoining structures, edges, or variations in total plating plus substrate thickness that are within the effective limit of penetration.
- f. The calibration of the instrument SHOULD be periodically checked against the standards to guard against instrument drift.
- g. Check all measured values against the tolerances specified by the written procedure. All abnormal values SHOULD be reported as required by the procedure.

4.5.29.4 Plating Thickness Reference Standards. Reference standards for plating thickness measurements must have the same electrical conductivity, magnetic permeability, and geometry as the part. These requirements apply to both the base material and the plating. Electrical conductivity and magnetic permeability for the base material are usually obtained by using the same alloy and temper for the standards as used in the part. Particular care SHOULD be taken in processing the materials to ensure that similar properties are obtained. The surface finishes of the part and standard SHOULD also be alike. To obtain the same electrical conductivity, magnetic properties, and surface finish for plating on the parts and reference standards, the plating must be performed in baths of similar composition and subject to similar controls. If the plating on the part is stress-relieved prior to thickness measurement, the references SHOULD receive the same treatment. Several methods of determining plating thickness on reference standards can be used. One of these is to carefully measure the thickness prior to plating and again after plating. The difference represents the thickness of the plating which is applied to one side only. A second method is to measure the plating on an adjacent area by sectioning a metallographic specimen. The total thickness of the plating plus substrate must exceed the effective depth of penetration in the part. A total thickness of 2.5 to 3 combined standard depth of penetration is usually considered sufficiently thick. This thickness may be determined by adding the standard depth of penetration in the plating and the substrate at the frequency used. For example, if approximately 0.003-inch thick silver plating on aluminum is to be measured at 200 kHz, the minimum total thickness can be determined as follows:

- The standard depth of penetration of silver at a frequency of 200 kHz is 0.007-inch. Therefore, the 0.003-inch of silver in the plating represents 0.4 standard depth of penetration
- The 2024-T3 aluminum base material must be at least $2.5 - 0.4 = 2.1$ standard depth of penetration
- If the conductivity and magnetic permeability of a metal are known, the standard depth of penetration can be determined

4.5.30 Measurement of Nonconductive Coatings.

4.5.30.1 Nonconductive Coatings. A wide variety of nonconductive coatings are applied to military hardware. Primers, paints, and plastics and sealants are widely used to protect metals from corrosion. Anodic coatings are used on metals, particularly aluminum, to prevent surface deterioration. Other oxide coatings provide protection against heat or wear. Boron epoxy laminates increase stiffness and strength. To control the thickness of such nonconductive coatings or to measure their loss during service, ET techniques have been used with a high degree of accuracy.

4.5.30.2 Basis for Measurement of Nonconductive Coatings. The determination of thickness of nonconductive layers or materials is a relative measure of the magnetic coupling between the probe and the underlying conductive material. In other terms, the thickness of a nonconductor is a direct measurement of lift-off or the spacing between the probe and the conductor. Because the properties (electrical conductivity, magnetic permeability, and geometry) of the underlying materials affect the signal detected by the probe, they must be constant or their variation minimized by instrument adjustment. Three requirements for measurement of nonconductive coatings by eddy current techniques are:

- The nonconductive coating must be in intimate contact with a conductive material
- The thickness of the coating must be less than the effective range of the varying magnetic field generated by the probe
- The thickness of the substrate must be at least 2.5 times the standard depth of penetration at the test frequency

NOTE

(NAVY Only) Follow PD-214 instructions for nonconductive coating thickness measurement.

4.5.30.3 Impedance Effects of Nonconductive Coatings. When an eddy current probe is placed on bare metal, the impedance of the coil is changed by an amount that is dependent on the frequency of the oscillating current, the conductivity, magnetic permeability, and geometry of the test part, and the geometry and construction of the test coil. When impedance measuring eddy current instruments are used, the measurement of nonconductive coating thickness is determined from variation in current or voltage across the coil as the coil impedance changes due to increase or decrease in lift-off.

4.5.30.3.1 Influence of Material Properties and Frequency. An increase in the conductivity or magnetic permeability of the base metal or in the operating frequency improves the sensitivity of the thickness measurement of nonconductive coatings.

4.5.30.3.2 Test Systems for Nonconductive Coating Measurement. Nonconductive coating thickness can be measured with almost any ET system. Sensitivity is limited by the frequency attainable with available test instruments. Accuracy and range of measurement are increased with increasing frequency. The size and construction of available probes, and instrument circuit design affect the accuracy of measurement. Accuracy decreases with increases in coating thickness. Sometimes probes are spring-loaded to prevent variations in readings caused by inconsistent pressures.

4.5.30.3.3 Procedures for Measuring Nonconductive Coatings. The following steps SHOULD be followed to perform thickness measurements on nonconductive coatings:

- Establish the range of thickness to be measured and the accuracy required
- Select test system capable of performing required thickness measurement to specified tolerances
- Prepare the part or area for thickness measurement
- Prepare calibration curve or verify calibration curve with existing calibration standards. A calibration curve is required for each combination of instrument and probe and for each base metal
- Perform thickness measurement checking the calibration occasionally with the known calibration standard

4.5.30.4 Standards for Measurement of Nonconductive Coatings. If calibration standards are unavailable, standards for measurement of nonconductive coatings MAY be obtained from a number of sources. Layers of paper, plastic, and tape are three of the most available standards. Standards SHOULD be uniform in thickness and conform to the surface of the bare metal representing the part to be measured. When standards are stacked layers of material, no gaps or pockets should exist between the layers. Standards can also be actual sections of parts with known thicknesses of the nonconductive coating applied. These standards usually require more effort and expense to prepare. When possible, standards SHOULD be measured to an accuracy of 10 times greater than the accuracy required for the measurement of the nonconductive coating. This may not always be possible under field conditions. However, accuracy measuring the standard SHALL be at least 3 times better than the required measurement (e.g., If measurement to ± 0.003 is required, the standard must be measured to ± 0.001). Materials soft enough to compress under the pressure of a firmly applied probe should not be used.

SECTION VI INTERPRETING EDDY CURRENT SIGNALS

4.6 ET INTERPRETATION.

4.6.1 Flaw Detection. When eddy currents are induced in a metal in the region of a crack or other flaw, the eddy current flow is distorted. The distortion results in a localized decrease in electrical conductivity. In this manner an ET is able to detect flaws

4.6.1.1 Evaluation of Crack Indications.

4.6.1.1.1 Acceptance Rejection Criteria. In most cases, the depth of flaws detected by ET cannot be directly measured. In almost all cases, the eddy current signal of the flaw must be compared to the eddy current signal produced by the reference standard. The relationship between response to the standard and the corresponding response to the defect size must be established prior to the test and should be considered an essential part of the setup process. Prior to the start of any test, the instrument setup process SHOULD confirm that the test can be conducted with the required sensitivity.

4.6.1.1.2 Conditions Affecting Flaw Evaluation. Inspection for cracks, measurement of conductivity, or hardness can often be complicated by the surface damage, and manufacturing processes. Included in this category are scratches, gouges, pitting, and metal smearing. Severe damage may require refinishing of the area prior to inspection, inspection at a lower sensitivity, or selection of another test method.

4.6.1.1.3 **Discontinuities.** Discontinuities in an electrically conductive material can also change the circular eddy current flow pattern as shown in [Figure 4-57](#). Discontinuities include cracks, inclusions, voids, seams, pits, laps, and numerous other material variables related to the production, fabrication and use of metallic parts. The change in the magnitude and distribution of the eddy currents is roughly proportional to the size of the discontinuity intercepted by the eddy currents. Because of the weaker eddy currents at increasing depths beneath the surface, the eddy current response to flaws at or near the surface is greater than the reaction from same size flaws at greater depths.

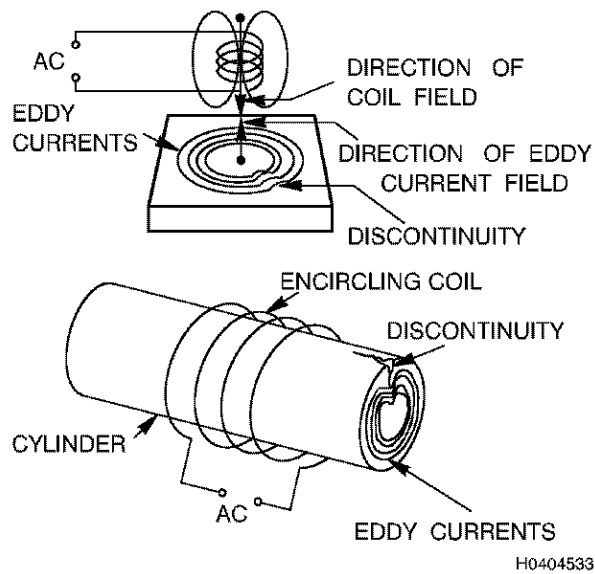


Figure 4-57. Effect of Discontinuities on Distribution of Eddy Currents

4.6.1.1.4 **Metal Smearing.** Flowing of surface metal may result from machining operations, abrasion during service, or by deformation during assembly or disassembly of an aircraft or component. The depth of smearing in nonmagnetic materials and its metallurgical effects will rarely exceed 0.002 to 0.003-inch. At normal crack detection frequencies, the metallurgical changes created by smeared metal may not affect eddy current response. However, metal build-up and depressions associated with the smearing create changes in lift-off. Because the phase angle is displayed, impedance plane analysis instruments will detect flaws even with changes in lift-off. In ferromagnetic steel, eddy current penetration is very shallow and any blemish of the surface increases the difficulty of inspection.

4.6.1.1.5 **Metal Spacing.** The spacing of metal sheets separated by a nonconductive adhesive layer can be successfully measured by using an eddy current frequency for which the thickness of both metal sheets is less than, or equal to three times the corresponding standard depth of penetration.

4.6.1.1.6 **Scratches, Gouges, and Pitting.** Scratches, gouges, and pits may result in eddy current signals similar in magnitude to those from cracks. As test frequencies increase, the sensitivity to scratches tends to increase, because the eddy current field is more concentrated at the surface.

4.6.1.1.7 **Rate of Deflection.** Rapidity of response with an impedance plane display instrument is also a means of evaluating indications. When traversing a crack, a quick rapid deflection is obtained. Variations in conductivity, gradual thickness changes, out-of-round holes, and variations in edge-to-probe spacing provide a slow, gradual change in measured response. The inspector SHOULD be aware of the rate of change in response from cracks, as contrasted to the rate of signal change from slow changing material properties or test conditions.

4.6.1.1.8 **Estimation of Crack Size.** Cracks have the three dimensions of length, width, and depth. All three of these dimensions have an effect on the eddy current response from the flaw. In general, the length of the flaw can be related to the distance over which a signal above a specified level is obtained. When the crack is perpendicular to the surface and is less than 2 standard depths of penetration deep, the approximate depth of the crack can be estimated from the eddy current indication. With impedance plane analysis instruments the depth can be determined by the phase angle and amplitude of the indica-

tion. The width of the crack also influences the magnitude of the indication. With impedance plane analysis instruments, the signal shape, phase, and amplitude can be used to estimate the depth and area of the crack. In general, a crack will be as deep or deeper than indicated by comparing its ET response to the response from the reference EDM notches.

4.6.2 Effect of Scan Rate and Pattern.

4.6.2.1 Signal Response of Impedance Plane Analysis Instruments. The speed of manual scanning with impedance plane analysis instrumentation does not affect signal response because the system response time is not limited by the response of a meter movement.

4.6.2.2 Indications on Digital Display or Strip Chart Recorder. The use of a strip chart recorder or digital display for recording indications during manual scanning of fastener holes makes evaluation less subjective. Comparison of rate of deflection from indications in the hole and the reference can be observed at the same time.

4.6.2.3 Indications with Automatic Bolt-Hole Scanning. Due to the rough surface of many bolt holes, numerous indications are obtained from causes other than cracks. Indications should therefore be examined carefully to establish if indications could be from cracks or if they are attributable to other causes. Evaluation can be made on the basis of direction of deflection and rate of deflection.

4.6.2.4 Indications from Indexing Automatic Scanners. The controlled rate of scanning obtained with the indexing automatic scanning (rotational/translational scanners) unit provides additional improvement in ease of evaluation. Because of the small scanning increment (pitch of scanner screw), usually 0.025-inch (40 threads to the inch), any crack of significant size will be detected during at least three consecutive revolutions of the scanner. This should result in three or more evenly spaced indications on the strip chart recorder or digital display. If crack-like indications are observed, inspect the hole visually to determine if the indications are due to obvious deformations such as metal tears or gouges. Gouge indications, while cyclic in nature, are generally recognized due to the fact such indications usually appear 180-degrees opposite in phase (or polarity) to crack or slot indications. Additionally, a gouge indication will usually not be as sharply peaked as an indication from a crack or slot. Careful study must be made of such indications to ensure that they do not mask an indication of a crack at the bottom of the gouge.

4.6.3 Openings, Large Holes, and Cutouts.

4.6.3.1 Location and Orientation of Cracks. An opening or cutout in a stressed aircraft part serves as a stress riser and a potential source of fatigue cracks and/or stress corrosion cracks. Fatigue cracks initiate at the edges of an opening, hole, or cutout and grow away from the edge at right angles to the direction of stress. Stress corrosion cracking usually occurs in sections subject to either an applied or residual tensile stress. The direction of tensile stresses can often be defined by engineering stress analysis or from the history of previous cracking in the part. This application covers openings for doors and accesses in aircraft skins, cutouts at part edges, and attachment holes too large for bolt-hole probes.

4.6.3.2 Inspection Requirements. If inspection is required only for large cracks (greater than approximately 1/4-inch in length) adequate inspection can usually be performed without special equipment or fixtures. For such cracks, inspection can be performed sufficiently far enough from the edge to avoid interference from edge effects. To detect small cracks, a relatively constant probe-to-edge distance must be maintained. For maximum reliability, a fixture or probe guide is used to establish probe positioning.

4.6.4 Conductivity Measurement.

4.6.4.1 Size and Accuracy of Conductivity Standards. For convenience of transportation and storage, conductivity standards are usually kept relatively small. Standards must have sufficient size to prevent edge effects or thickness from having a bearing on conductivity readings. These requirements can be satisfied by requiring length and width to be 1-inch greater than the probe diameter and the thickness greater than 3.5 times the standard depth of penetration at the test instrument frequency. Standards should be flat, have a surface finish of 63 RMS or better, and be free of any coatings. Standards used for calibrating instruments immediately prior to measuring conductivity SHOULD be accurate within $\pm 0.5\%$ IACS of the nominal value. A second set of standards accurate within 0.35% IACS SHOULD be periodically made available for checking the performance of instruments and field calibration standards. Calibration standards shall be traceable to NIST. Standards are available from manufacturers of eddy current conductivity instruments.

4.6.4.2 Conductivity Range. The conductivity range of the standards must be within the range of the instrument and cover the range of conductivity values to be measured. The calibration blocks shall have the same change in resistivity with temperature as the test parts.

4.6.4.3 Stability of Standards. Excessively high temperatures and sudden changes in temperature can have damaging metallurgical effects on standards. Aluminum alloys are particularly susceptible to thermal shock. Surfaces of standards can also corrode if exposed to moisture or other hostile environments. Damage due to rough handling can cause erroneous conductivity readings. For these reasons, standards shall be transported and stored in dry, clean, protected areas not subject to excessive temperatures.

4.6.4.4 Number of Standards Required. A minimum of two calibration blocks with accurately determined conductivity values must be available for calibration of eddy current conductivity meters. When using general purpose instruments, the number of standards may vary from two to several depending on the inspection purpose and the accuracy required.

4.6.4.5 Inspection Procedures.

4.6.4.5.1 Conductivity Procedure Requirements. Procedures for conductivity measurement should take into account the varieties of environments and test part conditions which might be encountered. In preparing for conductivity measurement, the following steps should be considered:

- Background and objectives of the inspection
- Equipment requirements
- Part preparation
- Instrument calibration including calibration standards
- Conductivity measurement procedures
- Acceptance/rejection criteria

4.6.4.6 Background and Objectives. An understanding of the problem that initiates a conductivity measurement requirement enables the inspector to better interpret inspection results and handle unexpected test conditions. The purpose of the test can be separation of mixed or improper alloy, determination of improper heat treatment, and detection of heat or fire damaged material. The types of material involved and the location of the inspection SHOULD be specifically established. Heat and/or fire damage may be confined to a portion of a part and may vary in the degree of damage. These variables must be considered during conductivity measurement.

4.6.4.7 Part Preparation. As with all types of ET, areas on which conductivity measurement is to be performed must be free of any sharp slivers or foreign material that could damage a probe or cause lift-off changes. Such conditions can be removed with fine emery paper or other approved means. Conductivity measurements can be performed through nonconductive coatings that have thicknesses equal to or less than the amount of lift-off adjustment on meter type equipment. Both the thickness and uniformity of the coating thickness and the amount of lift-off adjustment provided should be checked prior to measuring conductivity through nonconductive coatings. If lift-off adjustment cannot be obtained, correction factors can be determined for uniform coatings by establishing the change in conductivity readings caused by the coating and adding this change to each of the measured values. Non-uniform coatings in excess of lift-off adjustment must be removed prior to measuring conductivity. Excessively rough surfaces SHOULD be smoothed with emery paper to provide a surface finish 250 RMS or better before performing conductivity measurements.

4.6.4.8 Calibration for Measuring Conductivity Values.

NOTE

See WP 407 00 of TO 33B-1-2 for a procedure for digital conductivity measurement.

- a. Select a sufficient number of standards to obtain a smooth continuous curve over the range of conductivity to be measured. The actual number of samples will depend on the expected range to be measured and the accuracy required.

- b. Adjust the instrument for lift-off, if applicable, and a standard representing approximately mid-range of the conductivities to be measured.
- c. Determine the meter or scope readings corresponding to each of the intermediate standards and record the conductivity value.
- d. Note each of the values on a graph with meter or scope readings on the vertical axis and conductivity values on the horizontal axis.
- e. Construct a smooth curve through all the points. The curve should increase or decrease smoothly throughout the range with no minimum or maximum values. This curve is used to measure conductivity with the specific instrument and probe.

4.6.4.9 Calibration for Separation of Mixed Alloys. To calibrate the general purpose instruments for separating two groups of materials with different conductivity, the instrument is set to obtain readings at one end of the scale for one group of material, and the other end of the scale for the second group of material. Lift-off is usually set on a specimen representing the group with the lower value of conductivity or permeability.

4.6.4.10 Calibration Check. Calibration SHOULD be checked approximately every 10-minutes during continual use and whenever abnormal values are obtained. Whenever an instrument is found to be out of calibration, all measurements performed since the previous calibration verification SHOULD be rechecked.

4.6.4.11 Acceptance/Rejection Criteria. Acceptance/rejection criteria can be found in the applicable TO or material specifications. Acceptable conductivity ranges for many aluminum alloys are shown in [Table 4-7](#) in [Paragraph 4.8](#).

SECTION VII EDDY CURRENT PROCESS CONTROL

4.7 ET PROCESS CONTROL.

4.7.1 General. For maximum reliability in ET, a high signal-to-noise ratio is desired. No specific signal-to-noise ratio is mandatory, but a minimum of 3-to-1 is desirable for flaw detection

4.7.2 Specific. Specific procedures are part of the general set up requirements for inspection published in TO 33B-1-2. To catch weak or defective probes before they are needed for an inspection, new probes SHOULD be tested for adequate performance upon receipt.

SECTION VIII EDDY CURRENT EQUATIONS

4.8 EDDY CURRENT EQUATIONS.

Table 4-1. Common Applications of Eddy Current Inspection

Electrical Conductivity	Magnetic Permeability	Geometry	Material Discontinuities	Lift-Off or Fill-Factor
Alloy Sorting	Alloy Sorting	Metal Thickness	Cracks	Insulation Thickness
Heat-Treat Condition	Heat-Treat Condition		Segregation	Nonmetallic Coatings Thickness
Heat Damage	Case Depth		Seams	Proximity Gage
Plating Thickness	Plating Thickness		Inclusions	Diameter (e.g. of bar stock with encircling coil)
Cladding Thickness			Corrosion	
			Porosity	
			Carbon Fiber Breakage	
* Ferromagnetic Materials Only				

Table 4-2. Conductivities of Some Commonly Used Engineering Materials

Metal	Conductivity	60 kHz Probe	480 kHz Probe	Resistivity
	% IACS	Minimum Thickness (Inch)	Minimum Thickness (Inch)	$\mu \Omega \text{ cm}^*$
Silver	105	0.028	0.010	1.64
Copper, annealed	100	0.028	0.010	1.72
Aluminum Bronze- 5%, annealed	17	0.068	0.024	10.14
70-30 Brass	28	0.053	0.019	6.16
Cartridge Brass	28	0.053	0.019	6.16
Phosphor Bronzes	11	0.085	0.030	15.68
Phosphor Bronze- 5%, annealed	15	0.073	0.026	11.50
Gold	73.4	0.033	0.012	2.35
Magnesium	37	0.046	0.016	4.66
Magnesium, K60A-0	30	0.052	0.018	5.75
Magnesium, AZ31B- T5	18.5	0.066	0.023	9.32
Nickel, 99.4%	18	0.067	0.024	9.58
Nickel, 99.95%	25.2	0.056	0.020	6.84
Inconel 600	1.7	0.217	0.077	101.43
Monel 400	3.6	0.149	0.053	47.90
Monel	3.6	0.149	0.053	47.90
Zirconium	3.4	0.153	0.054	50.72
Zircaloy-2	2.4	0.182	0.064	71.85

Table 4-2. Conductivities of Some Commonly Used Engineering Materials - Continued

Metal	Conductivity	60 kHz Probe	480 kHz Probe	Resistivity
	% IACS	Minimum Thickness (Inch)	Minimum Thickness (Inch)	$\mu \Omega \text{ cm}^*$
Titanium	3.1	0.160	0.057	55.62
Ti-55A	3.1	0.160	0.057	55.62
Ti-8Al-1Mo-1V	0.87	0.303	0.107	198.20
Ti-6Al-4V	1	0.282	0.100	172.43
430 Stainless Steel	2.9	0.166	0.059	59.46
304 Stainless Steel	2.5	0.179	0.063	68.97
Inconel 600	1.7	0.217	0.077	101.43
Hastelloy X	1.5	0.231	0.082	114.95
Waspaloy	1.4	0.239	0.084	123.17
Platinum, 99.85%	16.3	0.070	0.025	10.60
Cobalt	27.6	0.054	0.019	6.24
Lead, 99.73%	8.4	0.098	0.035	20.65

* micro ohm centimeter

Table 4-3. Conductivity and Effective Depth of Penetration in Various Metals

Metal	Conductivity	60 kHz Probe	480 kHz Probe	Resistivity
	% IACS	Minimum Thickness (Inch)	Minimum Thickness (Inch)	$\mu \Omega \text{ cm}^*$
Silver	105	0.028	0.010	1.64
Copper, annealed	100	0.028	0.010	1.72
Aluminum Bronze- 5%, annealed	17	0.068	0.024	10.14
70-30 Brass	28	0.053	0.019	6.16
Cartridge Brass	28	0.053	0.019	6.16
Phosphor Bronzes	11	0.085	0.030	15.68
Phosphor Bronze- 5%, annealed	15	0.073	0.026	11.50
Gold	73.4	0.033	0.012	2.35
Magnesium	37	0.046	0.016	4.66
Magnesium, K60A- 0	30	0.052	0.018	5.75
Magnesium, AZ31B-T5	18.5	0.066	0.023	9.32
Nickel, 99.4%	18	0.067	0.024	9.58
Nickel, 99.95%	25.2	0.056	0.020	6.84
Inconel 600	1.7	0.217	0.077	101.43
Monel 400	3.6	0.149	0.053	47.90
Monel	3.6	0.149	0.053	47.90
Zirconium	3.4	0.153	0.054	50.72
Zircaloy-2	2.4	0.182	0.064	71.85
Titanium	3.1	0.160	0.057	55.62
Ti-55A	3.1	0.160	0.057	55.62
Ti-8Al-1Mo-1V	0.87	0.303	0.107	198.20
Ti-6Al-4V	1	0.282	0.100	172.43

Table 4-3. Conductivity and Effective Depth of Penetration in Various Metals - Continued

Metal	Conductivity	60 kHz Probe	480 kHz Probe	Resistivity
	% IACS	Minimum Thickness (Inch)	Minimum Thickness (Inch)	$\mu \Omega \text{ cm}^*$
430 Stainless Steel	2.9	0.166	0.059	59.46
304 Stainless Steel	2.5	0.179	0.063	68.97
Inconel 600	1.7	0.217	0.077	101.43
Hastelloy X	1.5	0.231	0.082	114.95
Waspaloy	1.4	0.239	0.084	123.17
Platinum, 99.85%	16.3	0.070	0.025	10.60
Cobalt	27.6	0.054	0.019	6.24
Lead, 99.73%	8.4	0.098	0.035	20.65

* micro ohm centimeter

Table 4-4. Conductivity and Effective Depth of Penetration in Nonclad Aluminum Alloys

Nonclad Aluminum Alloy	Temper	Conductivity (% IACS)	60 kHz Probe Minimum Thickness	480 kHz Probe Minimum Thickness
1100	T0	57-62	0.037	0.013
3003	T0	44.5-50.5	0.042	0.015
5052	T0	34-37	0.048	0.017
2014	T0	43.5-51.5	0.043	0.015
2014	T3	31.5-35	0.050	0.018
2014	T4	31.5-34.5	0.050	0.018
2014	T6	35.5-41.5	0.047	0.017
2024	T0	46-51	0.042	0.015
2024	T3	28.5-32.5	0.053	0.019
2024	T4	28.5-34	0.053	0.019
2024	T6	36.-40.5	0.047	0.017
2024	T8	35-42.5	0.048	0.017
2048	T8	35-42.5	0.048	0.017
2124	T3	28.5-32.5	0.053	0.019
2124	T8	35-42.5	0.048	0.017
2219	T0	44-49	0.043	0.015
2219	T3	26-31	0.055	0.020
2219	T37	27-31	0.054	0.019
2219	T4	28-32	0.053	0.019
2219	T6	32-35	0.050	0.018
2219	T8	31-35	0.051	0.018
2219	T87	31-35	0.051	0.018
6061	T0	42-49	0.044	0.015
6061	T4	35.5-43	0.047	0.017
6061	T6	40-47	0.045	0.016
6063	T0	57-65	0.037	0.013
6063	T1	48-58	0.041	0.014

Table 4-4. Conductivity and Effective Depth of Penetration in Nonclad Aluminum Alloys - Continued

Nonclad Aluminum Alloy	Temper	Conductivity (% IACS)	60 kHz Probe Minimum Thickness	480 kHz Probe Minimum Thickness
6063	T4	48-58	0.041	0.014
6063	T5	50-60	0.040	0.014
6063	T6	50-60	0.040	0.014
6066	T0	42-47	0.044	0.015
6066	T4	34-41	0.048	0.017
6066	T6	38-50	0.046	0.016
7049	O	44-50	0.043	0.015
7049	T73	40-44	0.045	0.016
7049	T76	38-44	0.046	0.016
7050	T0	44-50	0.043	0.015
7050	T73	40-44	0.045	0.016
7050	T736	40-44	0.045	0.016
7050	T76	39-44	0.045	0.016
7075	T0	44-48	0.043	0.015
7075	T6	30.5-36	0.051	0.018
7075	T73	40-43	0.045	0.016
7075	T76	38-42	0.046	0.016
7178	T0	43-47	0.043	0.015
7178	T6	29-34	0.052	0.019
7178	T76	38-42	0.046	0.016

Table 4-5. Standard Depths of Penetration for Metal Alloys at Various Frequencies

Metal	Conductivity % IACS	Standard Depth of Penetration (Inches)											
		100 Hz	500 Hz	1 kHz	5 kHz	10 kHz	50 kHz	100 kHz	200 kHz	500 kHz	1 MHz	2 MHz	6 MHz
Silver	105	0.254	0.113	0.080	0.036	0.025	0.011	0.008	0.006	0.004	0.003	0.002	0.001
Copper, annealed	100	0.260	0.116	0.082	0.037	0.026	0.012	0.008	0.006	0.004	0.003	0.002	0.001
Aluminum Bronze 5% annealed	17		0.282	0.199	0.089	0.063	0.028	0.020	0.014	0.009	0.006	0.004	0.003
70-30 Brass	28	0.491	0.220	0.155	0.069	0.049	0.022	0.016	0.011	0.007	0.005	0.003	0.002
Cartridge Brass	28	0.491	0.220	0.155	0.069	0.049	0.022	0.016	0.011	0.007	0.005	0.003	0.002
Phosphor Bronzes	11		0.351	0.248	0.111	0.078	0.035	0.025	0.018	0.011	0.008	0.006	0.003
Phosphor Bronze 5% annealed	15		0.300	0.212	0.095	0.067	0.030	0.021	0.015	0.009	0.007	0.005	0.003
Gold	73.4	0.303	0.136	0.096	0.043	0.030	0.014	0.010	0.007	0.004	0.003	0.002	0.001
Magnesium	37	0.427	0.191	0.135	0.060	0.043	0.019	0.014	0.010	0.006	0.004	0.003	0.002
Magnesium K60A-0	30	0.475	0.212	0.150	0.067	0.047	0.021	0.015	0.011	0.007	0.005	0.003	0.002
Magnesium AZ31B- T5	18.5		0.270	0.191	0.085	0.060	0.027	0.019	0.014	0.009	0.006	0.004	0.002
Nickel 99.4%	18		0.274	0.194	0.087	0.061	0.027	0.019	0.014	0.009	0.006	0.004	0.003
Nickel 99.95%	25.2		0.232	0.164	0.073	0.052	0.023	0.016	0.012	0.007	0.005	0.004	0.002
Inconel 600	1.7				0.282	0.199	0.089	0.063	0.045	0.028	0.020	0.014	0.008
Monel 400	3.6			0.433	0.194	0.137	0.061	0.043	0.031	0.019	0.014	0.010	0.006
Monel	3.6			0.433	0.194	0.137	0.061	0.043	0.031	0.019	0.014	0.010	0.006
Zirconium	3.4			0.446	0.199	0.141	0.063	0.045	0.032	0.020	0.014	0.010	0.006
Zircaloy-2	2.4				0.237	0.168	0.075	0.053	0.038	0.024	0.017	0.012	0.007
Titanium	3.1			0.467	0.209	0.148	0.066	0.047	0.033	0.021	0.015	0.010	0.006
Ti-55A	3.1			0.467	0.209	0.148	0.066	0.047	0.033	0.021	0.015	0.010	0.006
Ti-8Al- 1 Mo- 1V	0.87				0.394	0.279	0.125	0.088	0.062	0.039	0.028	0.020	0.011
Ti-6Al- 4V	1				0.368	0.260	0.116	0.082	0.058	0.037	0.026	0.018	0.011
430 Stainless Steel	2.9			0.483	0.216	0.153	0.068	0.048	0.034	0.022	0.015	0.011	0.006
304 Stainless Steel	2.5				0.233	0.164	0.074	0.052	0.037	0.023	0.016	0.012	0.007

Table 4-5. Standard Depths of Penetration for Metal Alloys at Various Frequencies - Continued

Metal	Conductivity	Standard Depth of Penetration (Inches)													
		100 Hz	500 Hz	1 kHz	5 kHz	10 kHz	50 kHz	100 kHz	200 kHz	500 kHz	1 MHz	2 MHz	6 MHz		
Inconel 600	1.7				0.282	0.199	0.089	0.063	0.045	0.028	0.020	0.014	0.008		
Hastelloy X	1.5				0.300	0.212	0.095	0.067	0.047	0.030	0.021	0.015	0.009		
Waspaloy	1.4				0.311	0.220	0.098	0.069	0.049	0.031	0.022	0.016	0.009		
Platinum 99.85%	16.3		0.288	0.204	0.091	0.064	0.029	0.020	0.014	0.009	0.006	0.005	0.003		
Cobalt	27.6	0.495	0.221	0.157	0.070	0.049	0.022	0.016	0.011	0.007	0.005	0.003	0.002		
Lead 99.73%	8.4		0.402	0.285	0.127	0.090	0.040	0.028	0.020	0.013	0.009	0.006	0.004		

Table 4-6. Standard Depths of Penetration for Clad Aluminum Alloys at Various Frequencies

Clad Aluminum Alloy	Temper	Standard Depth of Penetration (Inches)												
		100 Hz	500 Hz	1 kHz	5 kHz	10 kHz	50 kHz	100 kHz	200 kHz	500 kHz	1 MHz	2 MHz	6 MHz	
2014	T6	0.436	0.195	0.138	0.062	0.044	0.020	0.014	0.010	0.006	0.004	0.003	0.002	
2024	T3	0.487	0.218	0.154	0.069	0.049	0.022	0.015	0.011	0.007	0.005	0.003	0.002	
2024	T4	0.487	0.218	0.154	0.069	0.049	0.022	0.015	0.011	0.007	0.005	0.003	0.002	
2024	T6	0.439	0.197	0.139	0.062	0.044	0.020	0.014	0.010	0.006	0.004	0.003	0.002	
2024	T8	0.439	0.197	0.139	0.0062	0.044	0.020	0.014	0.010	0.006	0.004	0.003	0.002	
2219	T6	0.460	0.206	0.145	0.065	0.046	0.021	0.015	0.010	0.007	0.005	0.003	0.002	
2219	T8	0.467	0.209	0.148	0.066	0.047	0.021	0.015	0.010	0.007	0.005	0.003	0.002	
6061	T6	0.411	0.184	0.130	0.058	0.041	0.018	0.013	0.009	0.006	0.004	0.003	0.002	
7075	T6	0.471	0.211	0.149	0.067	0.047	0.021	0.015	0.011	0.007	0.005	0.003	0.002	
7075	T76	0.422	0.189	0.133	0.060	0.042	0.019	0.013	0.009	0.006	0.004	0.003	0.002	
7178	T6	0.483	0.216	0.153	0.068	0.048	0.022	0.015	0.011	0.007	0.005	0.003	0.002	

Table 4-7. Conductivity and Effective Depth of Penetration for Clad Aluminum Alloys

Clad Aluminum Alloy	Temper	Conductivity Range (% IACS)	60 kHz Probe Minimum Thickness (Inch)	480 kHz Probe Minimum Thickness (Inch)
2014	T6	35.5-44	0.047	0.017
2024	T3	28.5-35	0.053	0.019
2024	T4	28.5-35	0.053	0.019
2024	T6	35-45	0.048	0.017
2024	T8	35-45	0.048	0.017
2219	T6	32-37	0.050	0.018
2219	T8	31-37	0.051	0.018
6061	T6	40-53	0.045	0.016
7075	T6	30.5-36	0.051	0.018
7075	T76	38-42	0.046	0.016
7178	T6	29-34	0.052	0.019

Table 4-8. Effects of Material and Inspection Variables on the Sensitivity and Range of Thickness Measurements

Variable Increased	Sensitivity of Measurement	Range of Measurement
Conductivity	Increases for thin metallic parts and plating. Increases throughout affect range for nonconductive coatings.	Decreases for metallic materials. Increases for nonconductive coatings.
Permeability	Increases for thin metallic parts and plating. Decreases for thick metallic parts and plating. Increases throughout for nonconductive coatings	Decreases for metallic materials. Increases for nonconductive coatings.
Frequency	Increases for thin metallic parts and plating. Decreases for thicker metallic parts and plating. Increases throughout the effective range for nonconductive coatings.	Decreases for metallic materials. Increases for nonconductive coatings.
Probe Diameter	Increases for thicker metallic parts and plating and throughout effective range for nonconductive coatings.	Increases for metallic parts, plating, and nonconductive coatings.

NOTE

The following formulas are used by NDI engineers and inspection developers. Technicians should have a working knowledge of the most basic electrical component equations as presented in the classroom.

4.8.1 Resistance. When DC flows through an element of an electric circuit, or AC flows through a circuit element having negligible inductance (e.g., a straight section of wire or a carbon resistor), the impedance is resistance only and is expressed as:

$$R = E / I$$

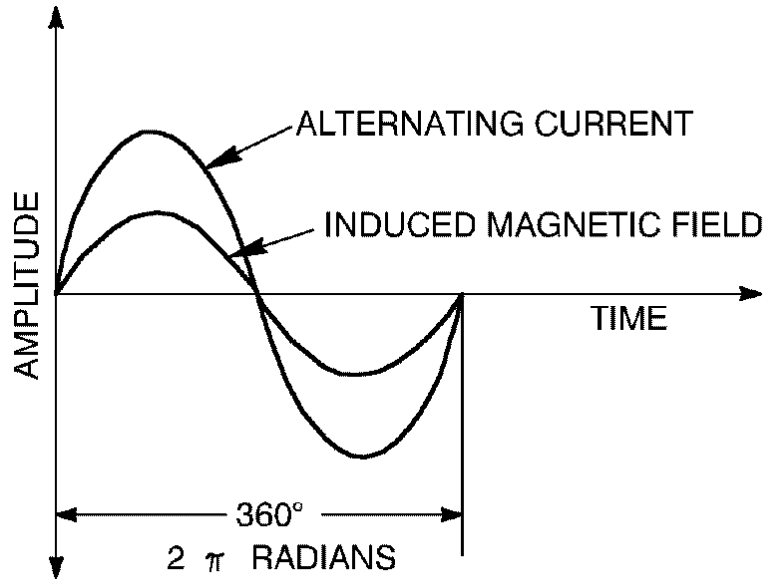
Where:

R = Resistance (ohms)

E = Voltage drop across the resistor (volts)

I = Current flowing through circuit (amperes)

4.8.1.1 In an AC circuit containing resistance only (i.e., having negligible inductance), the voltage and the current are in phase. The term "in phase", when used to describe the relationship between the voltage and current, indicates that changes in current occur at the same time and in the same manner (direction) as changes in voltage. Examples of two quantities that are in phase are shown in [Figure 4-58](#).



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Figure 4-58. Sinusoidal In-Phase Variation of Alternating Current and Induced Magnetic Field

4.8.1.2 Resistance.

$$R = \frac{\ell \rho}{A} \text{ ohm}$$

Where:

ℓ = Length of conductor

ρ = Resistivity

A = Area (cross sectional) of conductor

4.8.1.3 Resistivity.

$$\rho = \frac{RA}{\ell} \text{ ohm mm}$$

4.8.1.4 Conductivity (inverse of resistivity).

$$\sigma = \frac{\ell}{RA} \quad \text{mho/mm or siemen/mm}$$

$$1 \text{ mho} = \frac{1}{\text{ohm}}$$

4.8.2 Inductance. The inductance of an eddy current probe is the result of magnetic field effects of the alternating electric current in the probe. Inductance is a measure of the capability of a circuit to induce current flow in another circuit. It is proportional to the ratio of the magnetic flux linking (encircling) a circuit to the current (I) that produced the flux. When the flux from one inductor is linked to (passes through) another inductor, the inductance is called mutual inductance (M). An electrical transformer is an example of a device where "M" is a significant parameter. For eddy current testing, we consider only the inductance of a single circuit element, specifically, the coil used to sense changes in eddy current flows in test specimens. This inductance is called self-inductance (L).

$$L = \frac{0.8 \times (rN)^2}{6 \times r + 9 \times l + 10 \times b}$$

Where:

L = in micro-henries

r = mean coil radius

l = coil height

b = coil wrap thickness

N = number of turns

4.8.2.1 Self Inductance. Self-inductance (L) is expressed in "henries." A "henry" is the inductance by which one volt is produced across a coil when the inducing current is changed at the rate of one ampere per second. A formula for self-inductance expressed in these terms is as follows:

$$L = \frac{E}{(\delta I / T)}$$

Where:

L = Inductance (henries)

E = Induced Electromotive Force (volts)

δI = Change in Current (amperes)

T = Time (seconds)

Because the "henry" is such a large unit, inductance is more commonly expressed in terms of "millihenries" (1/1000 "henry") or "micro-henries" (1/1,000,000 "henry"). Typical coils used in ET have self-inductances in the range of 10 to several hundred "micro-henry."

4.8.3 Fill Factor. Is the ratio of the effective cross-sectional area of the primary internal probe coil to the cross-sectional area of the tube interior.

$$\eta = \left(\frac{D_o}{D_i} \right)^2$$

Where:

η = Fill factor

D_o = Outside diameter of test part

D_i = Inside diameter of coil

4.8.3.1 Fill Factor example: if an encircling coil with an internal diameter of 2.25-inches were used to inspect 2.00-inch diameter rod, the fill factor would be:

$$\eta = \left(\frac{D_o}{D_i}\right)^2 = \left(\frac{2.00}{2.25}\right)^2 = (0.889)^2 = 0.79$$

4.8.3.2 For internal coils, electromagnetic (inductive) coupling is determined by the air gap between the external diameter of the coil and the internal diameter being inspected. Fill-factor is calculated using the basic formula, but in this case D_i is the inside diameter of the part and D_o is the outside diameter of the coil placed in the part. For example, if a coil with an external diameter of 1.5-inches is used to inspect tubing with an internal diameter of 1.6-inches, the fill factor is given by:

$$\eta = \left(\frac{D_o}{D_i}\right)^2 = \left(\frac{1.5}{1.6}\right)^2 = (0.9375)^2 = 0.88$$

4.8.4 Inductive Reactance and Capacitive Reactance.

$$X_L = 2\pi fL$$

X_L = Inductive reactance in ohms

f = frequency in hertz

L = inductance in henrys

$$X_C = \frac{1}{2\pi fC}$$

f = frequency in hertz

C = capacitance in farads

X_C = capacitive Reactance in ohms

4.8.5 Impedance. Impedance is the opposition to current flow and is a two-dimensional parameter consisting of resistance and reactance. Resistance is the opposition to the flow of both direct and alternating current. Reactance is the opposition to flow of alternating current only. Reactance can be either capacitive or inductive. Both resistance and reactance are measured in ohms. Of primary interest in ET are resistance and inductive reactance, the latter due to inductance of a coil. Capacitive reactance becomes significant in only a few cases and will be discussed later. The impedance of a test coil is related to the current flow in and voltage drop across the coil as follows:

$$Z = \frac{E}{I}$$

Where:

Z = Impedance of coil (ohms)

E = Voltage drop across the coil (volts)

I = Current through coil (amperes)

4.8.5.1 Impedance formula:

$$Z = \sqrt{R^2 + (X_L - X_C)^2}$$

4.8.6 Permeability.

$$\mu = \frac{B}{H}$$

Where:

μ = permeability

H = magnetizing force oersteds or amp - turns

B = flux density in gauss or tesla (10000 G = 1 T)

4.8.6.1 Relative Permeability:

$$\mu_{rel} = \frac{B}{H\mu_0}$$

Where:

μ_0 of free space = $4\pi \times 10^{-7}$

Ferromagnetic $\mu_{rel} \gg 1$

Paramagnetic $\mu_{rel} \geq 1$ Nonferrous

Diamagnetic $\mu_{rel} < 1$ Au, I

4.8.7 Depth of Penetration (δ).

$$\rho = \frac{172}{IACS}, \text{ resistivity in micro-ohm cm}$$

$$\delta = 660 \sqrt{\frac{1}{IACS \times \mu \times f}}, \text{ depth of penetration in mm}$$

$$\delta = 26 \sqrt{\frac{1}{IACS \times \mu \times f}}, \text{ depth of penetration in inches}$$

$$\delta = 1.98 \sqrt{\frac{\rho}{\mu \times f}}, \text{ depth of penetration in inches, using resistivity in micro-ohm cm.}$$

4.8.7.1 Frequency necessary for one standard depth:

$$f = \frac{676}{\mu \times IACS \times \delta^2}$$

Where:

f = frequency in hertz, Hz

μ = relative permeability

$IACS$ = conductivity as a percentage of the conductivity of copper

δ = the standard depth of penetration in inches

4.8.7.2 Phase Lag at one Standard Depth:

$$\theta = \frac{\text{Depth}}{\delta} \times 57^\circ$$

Phase lag on impedance diagram is

2 times θ , signal down and
 back at 1δ phase lag is 114°

4.8.8 Limit Frequency, f_g , and the "Similarity" Law.

$$f_g = \frac{5066}{d^2 \mu \sigma}$$

$$\sigma \dots = \text{conductivity} = \frac{m}{ohm \dots mm^2}$$

Where:

d = diameter of test object in cm

f = frequency I Hz

$\mu_{rel} = \dots$ = relative permeability

4.8.9 Characteristic Frequency. f_g is lowest frequency where eddy currents are induced in a material. Where frequency and conductivity for one material is known, the frequency for "similar" phase separation can be calculated for another material of known conductivity.

$$f_1 \times \sigma_1 = f_2 \times \sigma_2$$

4.8.10 Coverage of Coil or Effective Coil Diameter.

Unshielded = coil diameter + 4δ

Shielded = coil diameter

δ = Standard depth of penetration

4.8.11 Calculating Flaw Frequency for Setting Filters. Assume flaw is infinitely narrow compared to coil:

- For scanning across a surface, surface speed is how fast the probe is moved across that surface
- For a rotating bolt-hole inspection, surface speed depends on the rotational speed of the scanner and the diameter of the probe. Surface speed may be calculated as follows:

$$\text{Flaw Frequency} = \frac{\text{Surface Speed}}{\text{Effective Coil Diameter}}, H_z$$

$$\text{Surface Speed} = \text{Scanner RPM} \times \pi \times \text{Probe Diameter}$$

4.8.12 Measurement of Conductivity. Formula: $\Sigma = L/RA = 1/\rho$; therefore, $R = \rho L/A$

Where:

Σ = electrical conductivity (mhos/unit-length)

L = length

R = resistance (ohms)

A = cross-sectional area

ρ = resistivity (ohms-unit-length)

SECTION IX EDDY CURRENT SAFETY

4.9 EDDY CURRENT SAFETY.

4.9.1 Safety Requirements. Safety requirements SHALL be reviewed by the laboratory supervisor on a continuing basis to ensure compliance with provisions contained in AFMAN 91-203 or appropriate service directive as well as provisions of this technical order and applicable weapons systems technical orders. Recommendations of the Installation Bioenvironmental Engineering Office and the manufacturer regarding necessary personnel protective equipment SHALL be followed.

NOTE

AFMAN 91-203 or appropriate service directive, and equipment manuals SHALL be consulted for additional safety requirements.

4.9.2 General Precautions. Precautions to be exercised when performing eddy current inspection include consideration of exposure to electrical current. The following minimum safety requirements SHALL be observed when performing eddy current inspections:

4.9.2.1 Most eddy current units can operate safely in the Class I, Division 2 environment identified in *NFPA 70, National Electrical Code*. Conformance, when necessary, should be verified by either manufactures' statement or passing testing in accordance with MIL-STD-810. Probe or battery changes and recharging shall be performed outside this environment. Bolt hole scanners are NOT certified as meeting Class I Division 2 requirements so they should not be used in this type of environment.

4.9.2.2 Most eddy current instruments are NOT rated as "explosion proof" and not rated for use in the Class I, Division 1 environment.

4.9.2.3 Batteries, power cord, and charger/adaptor are provided with most eddy current instruments. Ensure the correct batteries, charger/adaptor, and power cord are used to avoid damage to instruments or serious injury to the user.

CHAPTER 5 ULTRASONIC INSPECTION METHOD

SECTION I GENERAL CAPABILITIES OF ULTRASONIC (UT) INSPECTION

5.1 INTRODUCTION.

5.1.1 Introduction to Ultrasonic Inspection. The term ultrasonic pertains to sound waves having a frequency greater than 20,000 Hz. For most ultrasonic nondestructive inspection, the ultrasound will be generated by a device called a transducer, which will be discussed at length later in this chapter. The more general term “search unit” is also used to refer to the device introducing ultrasound into a part. For purposes of this manual, the two terms are considered synonymous.

5.1.2 Development of Ultrasonics. Developments in submarine warfare in the mid-twenties created a need for underwater communication. Early research for a suitable communicating method led to the invention of sonar, underwater ranging, and depth indicating devices.

5.1.2.1 In the late thirties, considerable work was done in applying ultrasonic waves to nondestructive inspection of materials. The first instruments were considered to be laboratory items, and were mostly for metallurgical research. Since then, ultrasonics has come a long way. The need for ultrasonics has grown with the advancement of aircraft, materials, and technologies.

5.1.3 Ultrasonic Testing. Ultrasonics uses (ultra) sound to detect internal and external discontinuities ranging from cracks to disbands. Ultrasound can be used on almost any material to locate discontinuities from large disbands, down to the smallest defects. It can also be used to measure the overall thickness of a material, and the specific depth of a defect. The part requires little or no preparation; however, knowledge of the internal geometry of a part is critical to interpretation of any defect signal.

SECTION II PRINCIPLES AND THEORY OF ULTRASONIC INSPECTION

5.2 INTRODUCTION.

5.2.1 Characteristics of Ultrasonic Energy.

5.2.1.1 Characteristics of Sound. The transmission of both audible sound and ultrasound is characterized by periodic vibrations of molecules or other small volume elements of matter. The vibration propagates through a material at a velocity characteristic to that material. As a particle is displaced from its rest position by any applied stress, it moves to a maximum distance away from its rest position (this is called a maximum displacement). The particle then reverses direction and moves past its rest position to a maximum position in the negative direction (a second maximum displacement). The particle then moves back to its rest position, completing one cycle. This process continues until the source of vibration is removed and the energy is passed on to an adjacent particle. The amplitudes of vibration in parts being ultrasonically inspected impose stresses low enough, so that, there is no permanent effect to the part.

5.2.1.2 To better understand the characteristics of sound, you must understand the terms associated with ultrasonics.

5.2.1.2.1 The term “period” means the amount of time it takes to complete one cycle.

5.2.1.2.2 The term “velocity” means the distance traveled per unit time (distance/second).

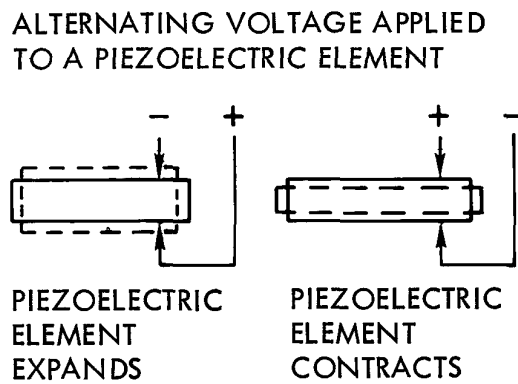
5.2.1.2.3 The term “frequency” means the number of complete cycles that occur in one second.

5.2.1.2.4 The term “hertz” means the cycles per second. For example: 1 hertz (Hz) = one cycle/sec; 1 kilohertz (kHz) = 1,000 cycles/sec; 1 Megahertz (MHz) = 1,000,000 cycles/sec.

5.2.1.2.5 The term “wavelength” is the distance a wave travels while going through one cycle.

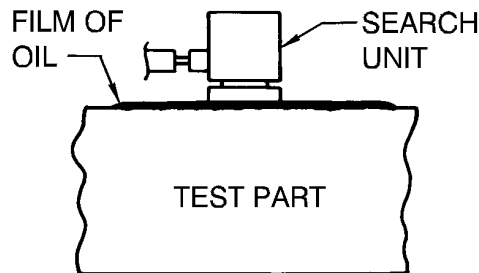
5.2.1.3 Unit Cells. Velocities in different materials vary due to the mass of the atoms which is related to the density of the material. Atoms are arranged in a structure defined by a unit cell. The common unit cells for metallic solids are body centered cubic (BCC), face centered cubic (FCC), and hexagonal close packed (HCP) where FCC and HCP materials have the higher densities which affect sound velocities.

5.2.2 Generation and Receiving of Ultrasonic Vibrations. Ultrasonic vibrations are generated by applying electrical energy to piezoelectric element contained within a transducer. This applied energy will be either a sudden high voltage spike from a discharging capacitor (a spike pulse), or a short pulse of constant voltage called a square wave. Also used where maximum power is needed from the transducer is a tone burst, which is a rapid series of square waves at a frequency matched to the transducer. The spike pulse is most commonly used. The transducer element transforms the electrical energy into mechanical energy (vibration) at a frequency determined by the material and thickness of the element. For aircraft NDI, this frequency will be ultrasonic. This element is also capable of receiving ultrasonic (mechanical) energy and transforming it into electrical energy (e.g., reverse piezoelectric) (Figure 5-1). Ultrasonic energy is transmitted between the transducer and the test part through a coupling medium (e.g., oil, grease, or water) (Figure 5-2). The purpose of a coupling material is to eliminate air at the interface between the transducer and the part under inspection. Air has high acoustic impedance, and thus, is a poor transmitter of ultrasound. Like audible sound waves, ultrasonic waves are capable of propagating through any elastic medium (solid, liquid, gas), but not in a vacuum. Propagation in any gas is very poor.



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Figure 5-1. Generation of Ultrasonic Vibrations



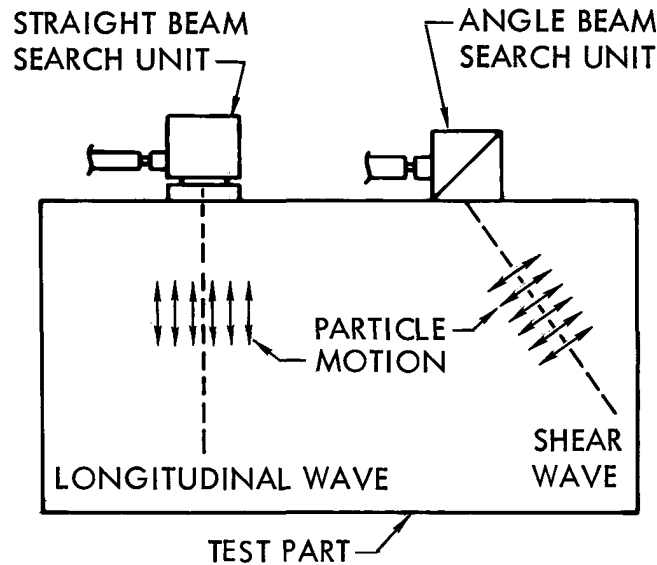
H0402814

Figure 5-2. Coupling Between the Transducer and the Test Part to Transmit Ultrasonic Energy

5.2.3 Modes of Ultrasonic Vibration. Ultrasonic energy is propagated in a material by the vibration of particles in the material. The mode of vibration is dependent upon the direction in which the particles vibrate in relation to the propagation di-

rection of the bulk ultrasonic beam. Ultrasonic waves are classified by the following modes of vibration: longitudinal, transverse, surface, and Lamb modes.

5.2.3.1 Longitudinal Waves. Waves in which the particle motion of the material moves in essentially the same direction as the sound wave propagation, are called longitudinal waves (also referred to as “compressional waves” or “L-waves”) (Figure 5-3). Longitudinal waves can be generated within solids, liquids, and gases. Longitudinal waves are generated in a part under inspection when an incident longitudinal wave is near normal (90°) to the surface of the part under inspection. The longitudinal wave velocity is determined by the material’s elastic modulus and density, and is a constant for each material. Longitudinal wave inspections are used extensively for thickness inspections, corrosion thinning, and for the detection of other defects parallel to the inspection surface.

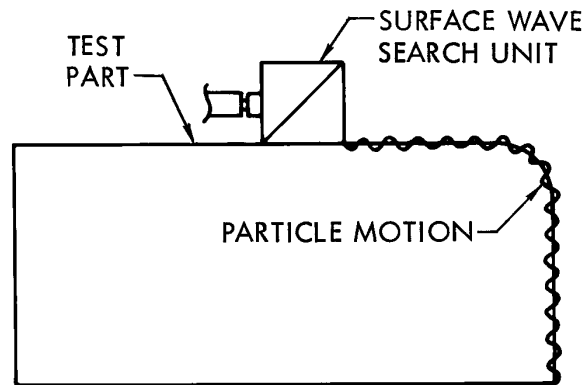


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Figure 5-3. Longitudinal and Transverse Wave Modes

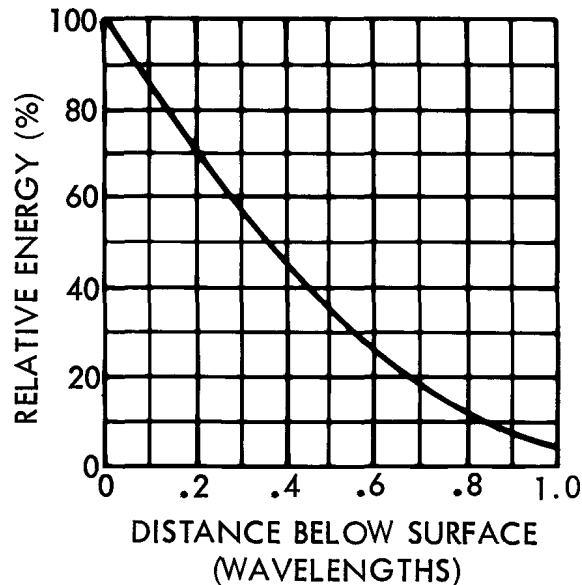
5.2.3.2 Transverse (Shear) Waves. Transverse (also known as “shear” or “s-wave”) waves denote the motion of waves in which the particle motion is perpendicular to the direction of propagation (Figure 5-3). These inspections are also called angle beam inspections. Shear waves travel at approximately 50-percent (half) of the velocity of longitudinal waves for the same material. Transverse waves can exist in any elastic solid, but are not supported by liquids or gases. Shear waves are generated in a test piece when a longitudinal wave impinges on the surface at an angle within a range of angles other than normal (90°) to the surface. This range is from the first to the second critical angles. These will be discussed at length later in this chapter. (The angle between the incident longitudinal wave and a line normal to the surface is referred to as the incident angle.) Part of the sound is reflected, but over a wide range of incident angles, part of the sound enters the test piece where mode conversion and refraction occur, resulting in a shear wave at an angle in the part. The portion converted to a shear wave will vary with the incident angle. Shear wave inspections are used extensively for crack and other defect inspections where the defect is suspected to be located at other than parallel to the inspection surface.

5.2.3.3 Surface (Rayleigh) Waves. Surface (Rayleigh) waves have a particle motion elliptical in a plane, parallel to the propagation direction, and perpendicular to the surface. Surface waves are generated when an incident longitudinal wave (Paragraph 5.2.4.2) impinges on the test piece at an incident angle just beyond the second critical angle for that material. Once generated, surface waves can travel along curves and complex contours. Surface waves travel at approximately 90-percent of the velocity of shear waves for the same material. Surface waves are confined to a thin layer of the material under inspection, up to one wavelength deep, and can only be sustained when the medium on one side of the interface is a gas. An angle beam transducer containing a steeply angled wedge is shown in Figure 5-4. The energy of surface waves decays rapidly below the surface of a test part as shown in Figure 5-5. Surface waves are most suitable for detecting surface flaws, but may also be used to detect discontinuities lying up to one-half wavelength below the surface.



H0402816

Figure 5-4. Surface Wave Mode



H0402817

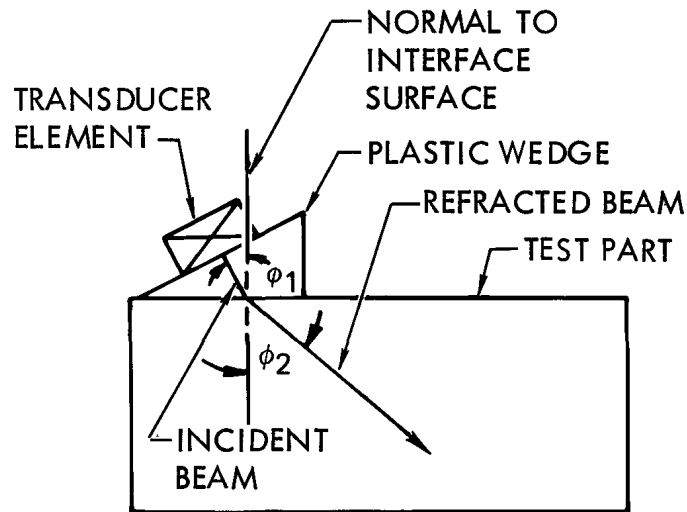
Figure 5-5. Distribution of Surface Wave Energy With Depth

5.2.3.4 Lamb (Plate) Waves. Lamb (plate) waves propagate within thin plates, a few wavelengths thick. Wave propagation is between the two parallel surfaces of the test piece, and can continue for long distances. Lamb waves are generated in a complex variety of modes. The propagation characteristics of Lamb waves are dependent on the properties and thickness of test material, as well as the test frequency. Two basic forms of Lamb waves exist symmetrical and asymmetrical. Although not widely used in production, Lamb waves are beneficial in large area inspection applications, such as corrosion and disbonds, because they can propagate for long distances.

5.2.4 Refraction and Mode Conversion.

5.2.4.1 Snell's Law. When an incident longitudinal beam is normal to the test part surface ($\theta_1 = 0^\circ$), the longitudinal sound beam is transmitted straight into the test part and no refraction occurs. When the incident angle is other than normal; refraction, reflection, and mode conversion occur. Refraction is a change in propagation direction. Mode conversion is a

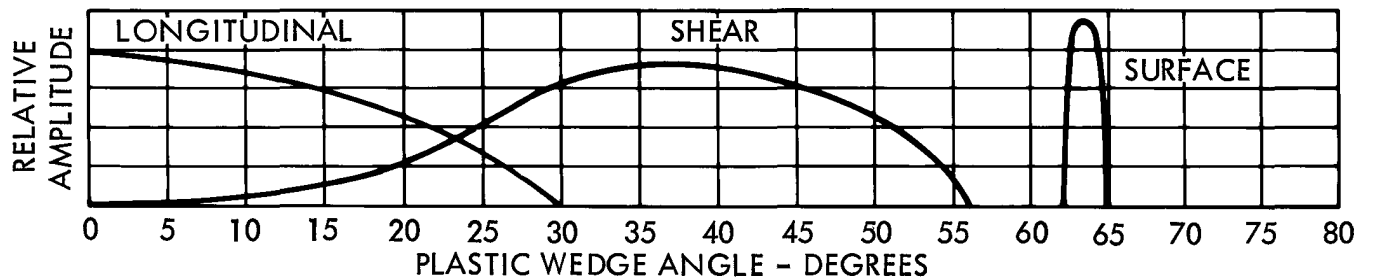
change in the nature of the wave motion. A portion of the longitudinal incident beam is refracted into one or more wave modes traveling at various angles in the test piece (Figure 5-6). Wave refraction at an interface is defined by Snell's Law. The Snell's Law formula is located in Paragraph 5.7.2.



H0402821

Figure 5-6. Sound Beam Refraction

5.2.4.2 Refracted Beam Energy. The relative energy for longitudinal, shear, and surface wave beams in steel, for different incident angles of longitudinal waves (Paragraph 5.2.3.1) in plastic, is shown in Figure 5-7. The curves shown were obtained using plastic wedges on steel. Similarly shaped curves MAY be obtained for other test materials (i.e., aluminum and titanium). Similarly curves MAY also be generated for the immersion inspection (Paragraph 5.4.2.1.1.2) in water. Refraction angles are greater in water than plastic.



H0402822

Figure 5-7. Relative Amplitude in Steel of Longitudinal, Shear, and Surface Wave Modes With Changing Plastic Wedge Angle

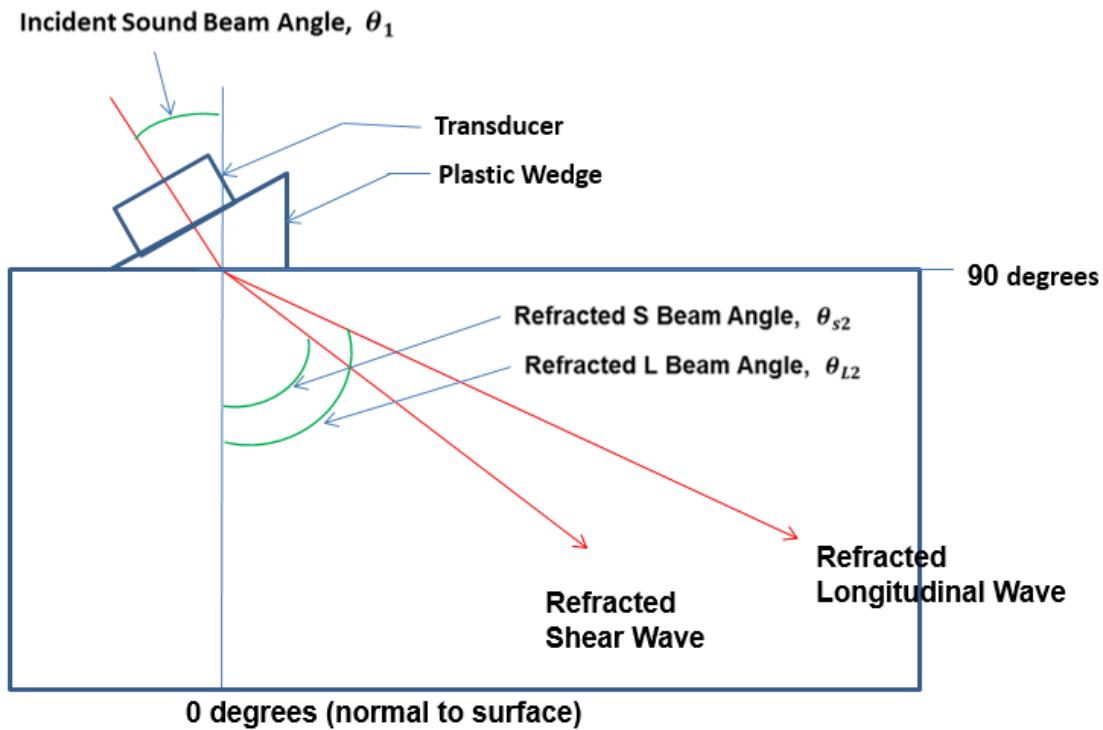


Figure 5-8. Multiple Refracted Beams

5.2.4.3 **Multiple Refracted Beams.** When an incident longitudinal beam is normal to the test part surface ($\theta_1 = 0^\circ$), the longitudinal sound beam is transmitted straight into the test part and no refraction occurs. When the incident angle is other than normal, refraction and mode conversion occur. A portion of the longitudinal beam is refracted at some angle greater than 0° and is mode converted into one or more wave modes traveling at various angles and intensities, depending on the incident angle of the longitudinal beam (Figure 5-8). The angles of the refracted and mode converted beams are determined by Snell's law (Paragraph 5.7.2). The relative energy for longitudinal, shear, and surface wave beams in steel, for different incident angles of longitudinal waves (Paragraph 5.2.3.1) in plastic, is shown in Figure 5-7. The curves shown were obtained using plastic wedges on steel. Similarly shaped curves can be obtained for other test materials, such as aluminum and titanium. Similarly curves can also be generated for the immersion inspection (Paragraph 5.4.2.1.1.2) with the plastic replaced by water. Refraction angles are greater with water than plastic.

5.2.4.3.1 **Critical Angles.** In angle beam inspection, it is important to know what types of waves and at what angles the waves exist in the test material. Because shear waves (Paragraph 5.2.3.2) and longitudinal waves (Paragraph 5.2.3.1) travel at different velocities in a given material, confusing signals can be generated and lead to false calls or missed indications.

5.2.4.3.1.1 **First Critical Angle.** The incident angle that yields a 90° refracted longitudinal wave is defined as the first critical angle. At incident angles equal to or greater than the first critical angle, longitudinal waves no longer exist in the material. Beyond this angle, only shear waves remain in the test material.

5.2.4.3.1.2 **Second Critical Angle.** The incident angle at which the refracted angle for shear waves reaches 90° is defined as the second critical angle. At incident angles equal to or greater than this, shear waves no longer exist in the material. Slightly beyond the second critical angle, surface waves (Paragraph 5.2.3.3) are propagated along the surface of the material.

5.2.4.3.1.3 Most angle beam inspections are performed with only a shear wave present in the test material, therefore most incident angles useful for shear-wave inspection NDI fall between the two critical angles. The first critical angle in plastic for steel (Figure 5-7) is approximately 30° ; the second critical angle is approximately 56° . For surface wave inspection the incident angle is purposely increased past the second critical angle to generate the desired surface wave.

5.2.4.4 Determining the Angle of Incidence in Plastic to Generate 45-Degree Shear Waves in Aluminum. Field NDI personnel are responsible for using the correct refracted beam angle for a particular application. The specific procedure details the correct refracted beam angle; however, it is important for the field NDI inspector to know how the correct angle was obtained. Snell's law is the tool for determining wedge angles for contact testing ([Paragraph 5.4.2.1.1.1](#)), or the angle of incidence in water for immersion testing ([Paragraph 5.4.2.1.1.2](#)). An example showing how Snell's law is used to determine the angle of incidence in plastic needed to generate 45° shear waves in aluminum is shown in [Paragraph 5.7.3](#).

5.2.5 Ultrasonic Inspection Variables. Ultrasonic inspection is affected by several variables. The ultrasonic inspection system consists of the instrument, transducer, wedges or shoes, coupling medium, etc. A discussion of variables related to the test part follows the paragraphs describing system variables. It is important the operator be familiar with and recognize the effects of all these variables.

5.2.5.1 Frequency. For flaw detection using the contact method ([Paragraph 5.4.2.1.1.1](#)), frequencies between 2.25 MHz and 10 MHz are commonly used. The higher frequencies in this range provide greater sensitivity for detection of small discontinuities, but do not have the penetrating power of the lower frequencies. The higher frequencies can also be more affected by small metallurgical discontinuities in the structure. Signals from these discontinuities can often interfere with the detection of relevant discontinuities, such as small cracks. The size of the defect detected SHOULD be the prime consideration when selecting the inspection frequency. Typically, defects must have at least one dimension equal to or greater than 1/2 the wavelength in order to be detected. For example, straight beam ([Paragraph 5.3.2.3.1](#)) inspection of aluminum at 2.25 MHz with a wavelength of 0.111-inch, requires a defect be 0.066-inch or larger in order to be detected (e.g., at 5 MHz, the minimum defect size is 0.025-inch and at 10 MHz, it is 0.012-inch).

5.2.5.2 Frequency Bandwidth. The above discussion on frequency pertains to the peak frequency used in an inspection. In all cases, the ultrasonic instrument and transducer produces a band of ultrasonic energy covering a range of frequencies. The range is expressed as bandwidth. Ultrasonic inspection procedures can be sensitive to frequency; therefore, the inspection results can be affected by variation in the bandwidth of the inspection system. For example, certain inspections use loss of back reflection as criteria for rejection. Frequencies too high can lead to diminished or complete loss of back reflection due to the sound being scattered by a rough inspection surface, large grain structure in the test material, or small non-relevant discontinuities. In other words, improper choice of peak frequency and bandwidth of the inspection system can produce irrelevant indications that affect inspection results. Both the instrument and the transducer affect the bandwidth of the inspection. Therefore, it is best to have a reference standard of the same material manufactured with the same manufacturing process and the same surface conditions as the test part, so the inspection results will be the same for different inspection systems. Instruments are constructed to pulse the transducer, and measure the response in different ways with respect to bandwidth.

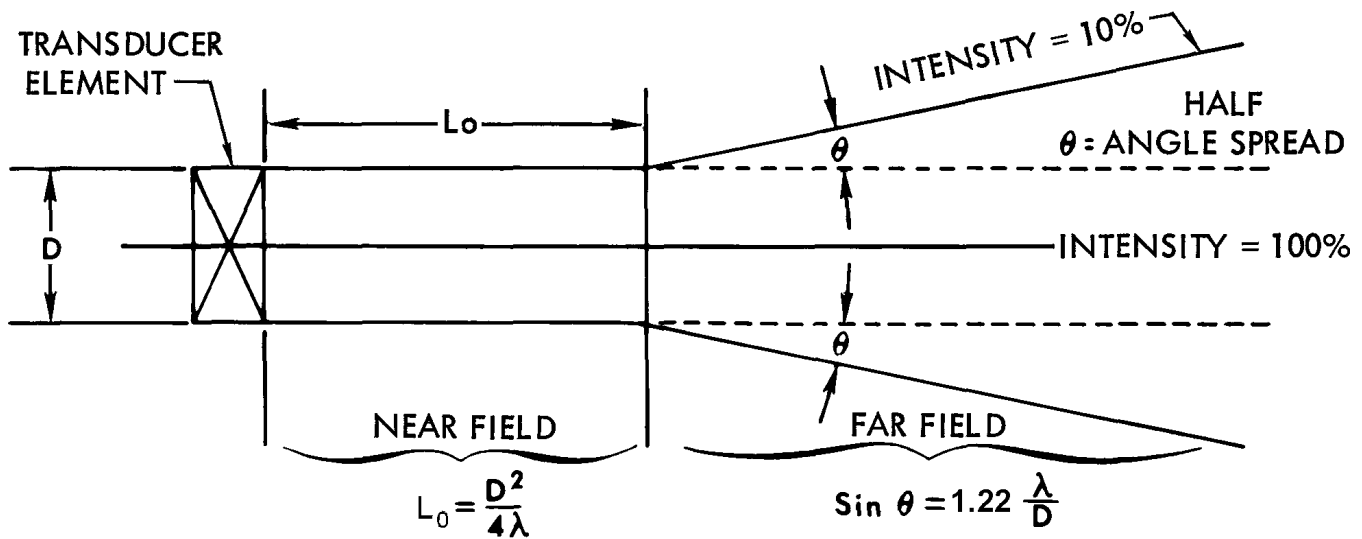
5.2.5.2.1 Some instruments use a spike pulser and a broadband amplifier. With these instruments, the bandwidth is controlled by the transducer. A given transducer has a maximum response at the natural resonant frequency of the transducer element; however, the element will also respond at other frequencies. The transducer response to these other frequencies is controlled by its internal construction. Modern instruments are designed to be operated in either narrow band or broadband modes to accommodate a variety of transducers. A broad bandwidth means better resolution; and a narrow bandwidth means greater sensitivity. Ultrasonic systems are generally designed with respect to bandwidth to provide a reasonable compromise between resolution and sensitivity.

5.2.6 Sound Beam Characteristics. The sound beam does not propagate uniformly through the volume defined by the straight-sided projection of the transducer face. Side lobes exist along the outer edges of the beam near the transducer face, and sound intensity is not uniform throughout the beam.

5.2.6.1 Dead Zone. During contact testing ([Paragraph 5.4.2.1.1.1](#)), there is test specimen thickness beneath the transducer in which no useful ultrasonic inspection can take place. This region is defined as the dead zone. When a transducer is excited, it vibrates for a finite amount of time during which it cannot act as a receiver for a reflected echo. Reflected signals from defects located in the dead zone arrive back at the transducer while it is still transmitting. A dead zone is inherent in all ultrasonic equipment. In some ultrasonic inspection equipment, the transmitted pulse length can be electronically shortened, effectively making the dead zone shallower, but it cannot be eliminated. The dead zone length can be estimated experimentally.

5.2.6.2 Near Field. Extending from the face of the transducer is an area characterized by wide variations in sound beam intensity. These intensity variations are due to the interference effects of spherical wave fronts emanating from the periphery of the transducer crystal. The region where this interference occurs is called the near field or Fresnel (pronounced Fraynel) Zone ([Figure 5-9](#)). The equation for calculating the length of the near field is located in [Paragraph 5.7.5](#). The smaller the

transducer element diameter or the lower the frequency, the shorter the near field will be. Due to inherent amplitude variations, inspection within the near field is not recommended without careful calibration on reference flaws within the near field.



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Figure 5-9. Schematic Presentation of Sound Beam

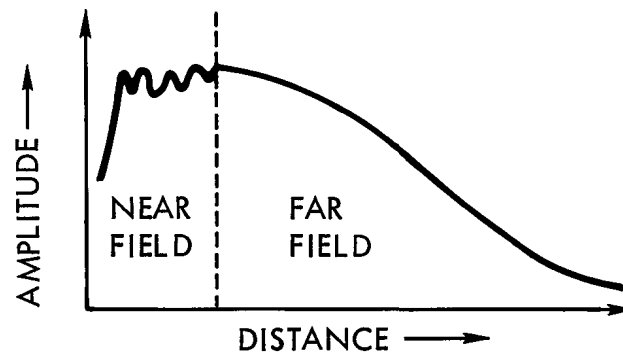
5.2.6.3 Far Field. At distances beyond the near field there are no interference effects. This region is called the far field (Fraunhofer Zone) (Figure 5-9). Most ultrasonic inspection procedures are designed to occur in the far field. The intensity of the sound beam in the far field falls off exponentially as the distance from the face of the transducer increases.

5.2.6.4 Distance Versus Amplitude.

NOTE

The important thing to remember is, wide variations in amplitude from discontinuities can occur when inspecting in the near field.

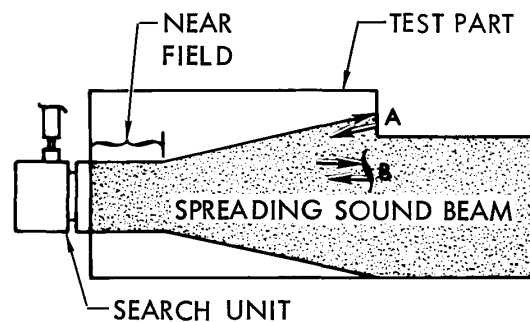
It is always best to compare discontinuity signals with signals from reference standards, such as flat-bottom holes having the same metal travel distance as the discontinuity. A typical curve showing the amplitude response versus distance from the transducer face is shown in Figure 5-10.



H0402823

Figure 5-10. Amplitude Response Curve of Typical Transducer

5.2.6.5 **Beam Spread.** In the near field, the sound beam essentially propagates straight out from the face of the transducer. In the far field, the sound beam spreads outward and decreases in intensity with increasing distance from the transducer face as shown in [Figure 5-10](#). Beam spread is important to consider because in certain inspection applications the spreading sound beam may reflect off of walls or edges, causing erroneous or confusing signals on the A-scan presentation ([Figure 5-11](#)). The formula for calculating the half-angle of the beam spread is located in [Paragraph 5.7.6](#).

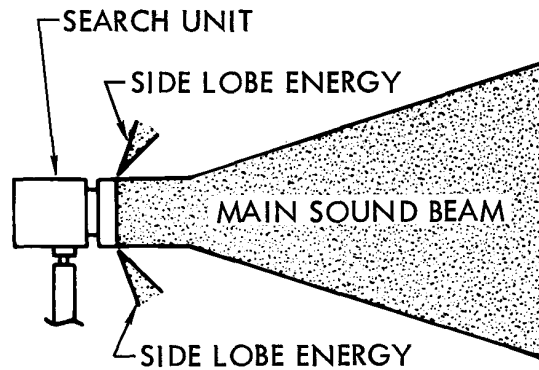


NOTE:
 THE BEAM SPREAD CAUSING THE RE-
 FLECTION FROM THE WALL AT A
 COULD MASK THE REFLECTED SIGNAL
 FROM THE DISCONTINUITY AT B.

H0402824

Figure 5-11. Example of Beam Spread Causing Confusing Signals

5.2.6.5.1 In addition to the main sound beam pattern discussed above, there is also a small amount of side lobe energy ([Figure 5-12](#)). Some of the effects of this side lobe energy are discussed in [Paragraph 5.5.3.1](#). Another adverse affect of side lobes, is a reduction in the efficiency of the transducer. Due to the interference created by the side lobes, the actual useable width of a sound beam near the face of the transducer is less than the actual width of the piezoelectric element ([Figure 5-12](#)).



H0402825

Figure 5-12. Main Sound Beam and Side Lobe Energy

5.2.6.6 **Beam Intensity.** Beam intensity is the sound wave energy transmitted through a unit cross-sectional area of the beam. The intensity is proportional to the square of the acoustic pressure exerted in the material by the sound wave. The acoustic pressure is directly related to the amplitude of the material particle vibrations caused by the sound wave. Transducer elements sense the acoustic pressure of the reflected sound wave and convert it to an electrical voltage. Ultrasonic instrument receiver-amplifier circuits receive the input voltage from the transducer and produce an output voltage value proportional to the intensity of the reflected sound. This output voltage is typically displayed on the instrument display as an A-scan signal.

5.2.6.7 **Attenuation.** Attenuation is the loss in acoustic energy that occurs between any two points of travel. The amount of loss is measured in decibels, but direct measurement of material attenuation can be very difficult. Beam attenuation occurs due to many factors that include absorption, scattering, diffraction, beam spread, geometry of the part, or other material characteristics.

SECTION III ULTRASONIC INSPECTION EQUIPMENT AND MATERIALS

5.3 INTRODUCTION.

5.3.1 Ultrasonic Instruments.

5.3.1.1 **General Description.** Ultrasonic equipment performs the functions of generating, receiving, and displaying pulses of electrical energy, which have been converted to and from pulses of ultrasonic energy by a transducer attached to an instrument. All portable ultrasonic equipment consists of a power supply, a clock circuit, a pulser, a sweep circuit, a transducer, a receiver-amplifier circuit, and an instrument display. By properly adjusting an instrument an operator can measure the amplitude of displayed pulse signals and determine the time/distance relationships of the received signals. Detailed instructions for operation of individual models SHALL be obtained by consulting the operating and maintenance manual for the specific instrument being used.

5.3.1.2 **Scanning Equipment.** Many applications lend themselves to either automated, or semi-automated scanning techniques. Most scanning applications are computer controlled and can result in A-scan, B-scan, or C-scan outputs. Scanning equipment ensures full coverage of the inspection zone and can be accomplished at resolutions unobtainable by manual scanning. Scanning mechanisms come in many levels of sophistication. Two-axis scanners can be manually manipulated or computer-automated to any extent. Large gantry-based immersion or "squirter" systems have up to 16 or more axes and offer full-contour scanning of complex shapes.

5.3.1.3 **Physical Characteristics of Instrument Controls.** The physical nature of the instrument controls varies with the type and age of the instrument. Older instruments have rotary knobs for fine adjustments, slide switches for coarse adjustments, and screwdriver rotary controls for infrequent adjustments, of waveform position and visibility. Newer instru-

ments have push buttons or a sealed membrane keypad, both to select the desired control from a displayed menu and to make the respective adjustments. Alternatively, some menu driven instruments have a single rotary (“smart”) knob for making adjustments after a control has been selected from the menu.

5.3.1.4 Waveform Display Controls. Modern ultrasonic instruments typically have a type of digital display such as a liquid crystal display (LCD), or electroluminescent (EL) display. Controls affecting the waveform display are discussed below.

5.3.1.4.1 Scale Display. The horizontal and vertical scales are displayed in various ways. On some instruments, the scales are scribed on the faceplate and cannot be altered. Instruments may include a choice of horizontal and vertical displays with or without numerical scaling. Depending on the instrument, the display is monochromatic or color and may have selectable levels of illumination or screen brightness.

5.3.1.4.2 Waveform Positioning Controls. The events in an ultrasonic inspection are related to time referenced to the pulses produced by the instrument. Pulses or signals will be represented along a horizontal line (typically called the sweep or baseline) at the bottom of the screen. Time starts at the left end of the sweep and progresses to the right. The sweep, included within the “frame” [Figure 5-13](#), is a visual presentation of a portion of the time base.

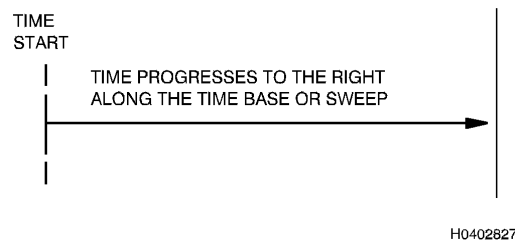


Figure 5-13. Time Base

5.3.1.4.3 Type of Waveforms.

5.3.1.4.3.1 Radio-Frequency (RF) Display, (Non-rectified). This type of waveform has the baseline at 50-percent of full screen height and shows the full waveform with both the positive and negative peaks. This type of waveform contains all of the signal information and is often used during procedure development to decide which waveform display is best suited for a particular inspection.

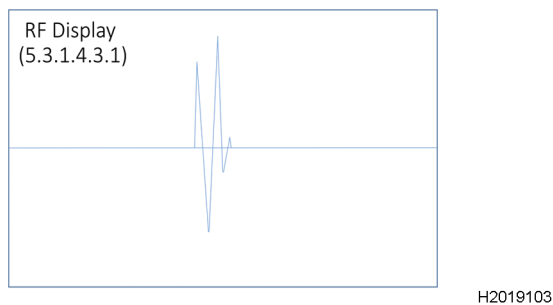
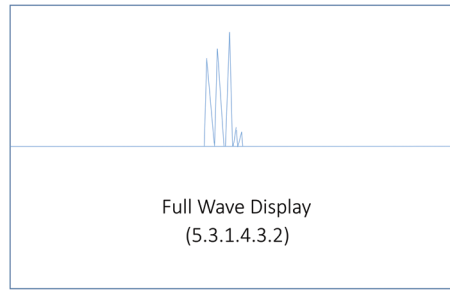


Figure 5-14. RF Display

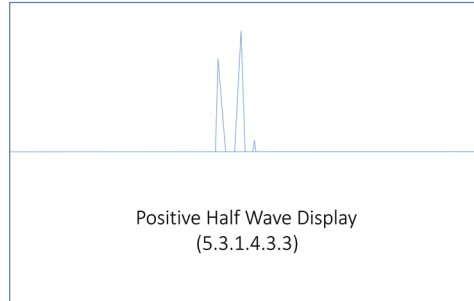
5.3.1.4.3.2 Full-Wave (FW) (Rectified Video Display). This type of waveform shows the positive peaks and the negative peaks, but the negative peaks are reversed and made positive. Refer to [Figure 5-15](#).



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Figure 5-15. Full Wave Display

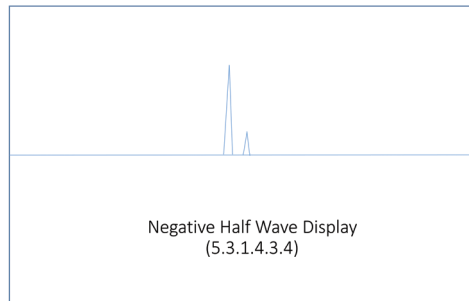
5.3.1.4.3.3 Positive Half-Wave (HW+ or HWP) (Rectified Video Display). This type shows only the positive peaks. Refer to [Figure 5-16](#).



H2019105

Figure 5-16. Positive Half Wave Display

5.3.1.4.3.4 Negative Half-Wave (HW- or HWN) (Rectified Video Display). This type shows only the negative peaks. Refer to [Figure 5-17](#).



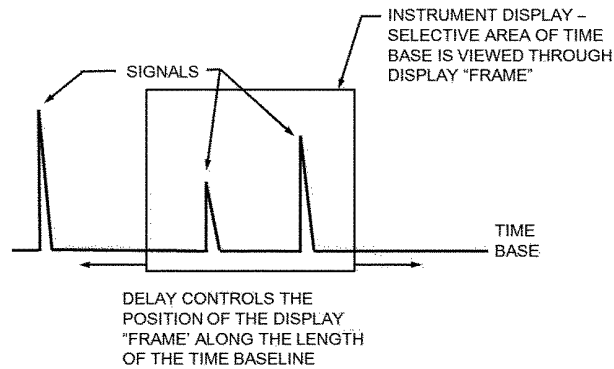
H2019106

Figure 5-17. Negative Half Wave Display

5.3.1.4.4 Video Filtering. Some instruments provide varying degrees of filtering of the rectified waveforms. Filtering smooths out the waveform, but some loss of information occurs. With minimum filtering, the presentation has greater resolution and signal definition. Video filtering MAY affect the vertical linearity of the instrument.

5.3.1.4.5 Sweep Delay. The sweep delay control (delay or display delay) determines what part of the time base is viewed on the display. An area circled to frame the portion of the time base that an inspector wants to view is shown ([Figure 5-18](#))

on the instrument display. Adjustments to the sweep delay move the frame to the desired portion of the time base, that is, sweep delay delays the start of the sweep with respect to the start of the time base.



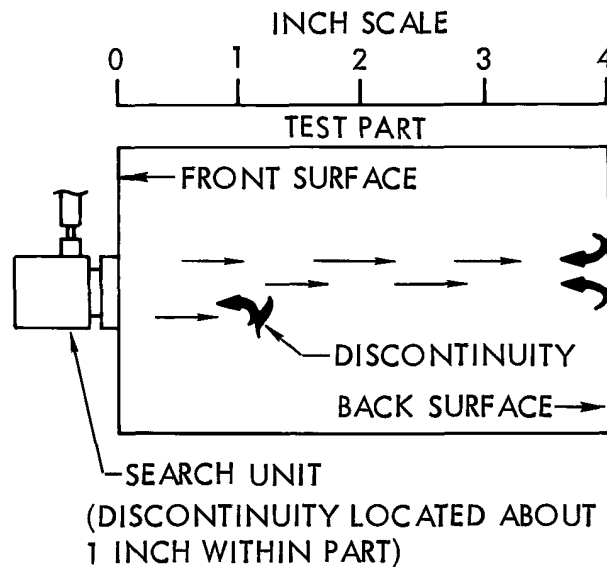
H0402828

Figure 5-18. Relationship of Display Sweep to Time Base

5.3.1.4.5.1 To see how the sweep delay works, consider the inspection shown in [Figure 5-19](#). Under certain control settings (e.g., immersion testing) ([Paragraph 5.4.2.1.1.2](#)), an instrument might have a sweep appear as in [Figure 5-20](#) showing only the front surface and discontinuity signals. By adjusting the sweep delay to move the “frame” to the right along the time base, the display shown in [Figure 5-21](#) is obtained.

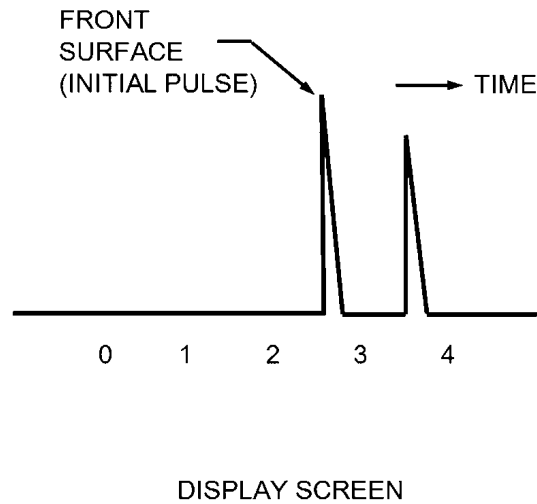
NOTE

The front surface signal now appears on the far left, and the back surface signal can now be viewed also. The distance between the front surface and the discontinuity signals has not changed from [Figure 5-20](#).



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Figure 5-19. Ultrasonic Contact Inspection



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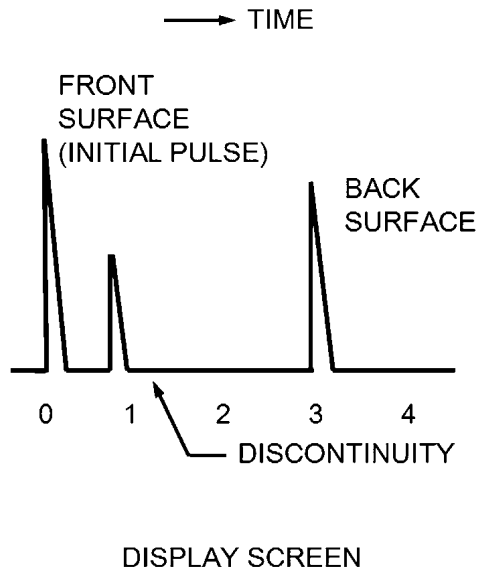
Figure 5-20. Display Screen Before Adjusting Sweep Delay

5.3.1.4.6 **Sweep Length/Range.** The sweep length (range) control determines how much time/distance is represented by the sweep on the display. If the range is adjusted to decrease the time/distance represented, the spacing between the signals will increase. The range control is used to calibrate the time base to specific distances for measurement purposes. In [Figure 5-21](#), if the sweep length/range is adjusted to decrease the time/distance represented (the sweep length/range), the spacing between the signals will increase, as seen in [Figure 5-22](#).

NOTE

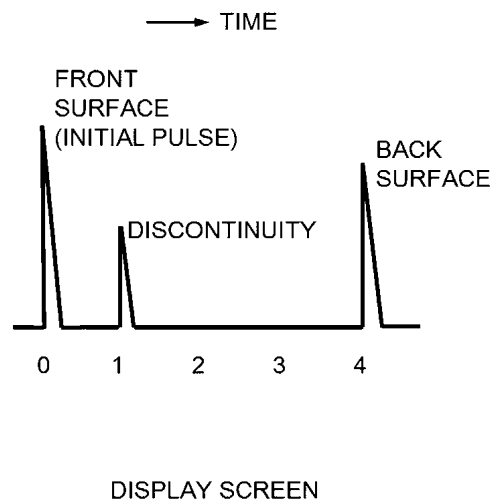
The front surface signal did not move; only the distances between the front surface signal and the other signals increased.

5.3.1.4.6.1 Referring back to [Figure 5-19](#), the 4-inch length of the test part and the 1-inch depth of the discontinuity are represented by the signals in [Figure 5-22](#) at “4” and “1” respectively. In other words, the sweep length/range control is used to calibrate the time base to the test part using the horizontal scale on the display.



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Figure 5-21. Display Screen After Adjusting Sweep Delay



H0402833

Figure 5-22. Effect of Sweep Length on Display

5.3.1.4.7 Zero Offset (Zero). A zero offset (zero or probe delay) control is a fine-delay control used to compensate for transducer face- plate wear. In angle beam inspections with a wedge, or straight beam inspections with a delay line, this control can be used to compensate for the distance the sound beam travels in a plastic wedge or delay line. Essentially, it allows the inspector to set “time zero” for electronic distance calculations to the exact instant the sound pulse enters the part.

5.3.1.4.8 Velocity. The velocity control allows the inspector to enter the material velocity of the material under inspection. By entering the velocity in conjunction with proper range and delay settings, the horizontal scale of the display will be automatically calibrated to provide the depth of any discontinuity detected in that particular test part.

5.3.1.5 Pulser Controls. When electronically triggered by the clock circuit, the pulser sends a high voltage spike to the transducer producing the initial pulse. Adjustments of the following pulser controls (if permitted by procedure) can be made to more clearly define the discontinuity indications.

5.3.1.5.1 Pulse Repetition Rate (Rep Rate or PRR). The pulse repetition rate is the actual number of trigger pulses produced per second and is controlled by the clock circuit. Typical rates are 300 to 2000 pulses per second. Typically, the higher the rate, the faster the scanning speed can be while still maintaining the required sensitivity. The maximum rep rate is the rate beyond which unattenuated echo signals occur on the display from an earlier pulse; this is called “wrap around” or “ghost” signals. These signals can be recognized by the occurrence of unexplained signals on the display which disappear if the rep rate is decreased while the transducer is held motionless on the test part. Some instruments include an automatic override to set the rep rate at a reduced value if the inspector tries to set it manually above a value compatible with the sweep settings.

5.3.1.5.2 Pulse Controls. On some instruments, the following controls are automatically set to default values when a new setup is initiated or when other interactive controls are adjusted. Adjustments of the following controls (if permitted) MAY be made to more clearly define the discontinuity indications.

NOTE

Minimum pulse length, (maximum damping) is obtained with the load resistance as small as possible for the circuitry. Load resistance selections may range from 16 ohms for maximum damping to 500 ohms for maximum pulse length (minimum damping).

5.3.1.5.2.1 Pulse Length (Damping). The pulse length (damping) control is used to adjust the time duration of the high-voltage spike pulse applied to the transducer. A higher damping value (shorter pulse length) provides the best near-surface resolution. A lower damping value (longer pulse duration) may provide more penetrating power for highly attenuative materials, such as rubber and concrete. The length of the initial pulse SHOULD be kept to a minimum, and increased only to gain signal strength when required; excessive pulse length can obscure signals from discontinuities close to the inspection surface (poor near-surface resolution).

5.3.1.5.2.2 Pulse Voltage. This control determines the amplitude of the generated initial pulse. Some instruments have incremental voltage adjustments; for example, from 40 to 400-volts in 5-volt increments. Other instruments have adjustments for only low, medium, or high voltages.

5.3.1.5.2.3 Pulse Width. Some instruments generate a square pulse as opposed to a spike pulse. The pulse width control sets the width of the square pulse, usually in nanoseconds. The effect of the pulse width is similar to the damping control, although the electronic nature of each is different.

5.3.1.6 Receiver Controls.

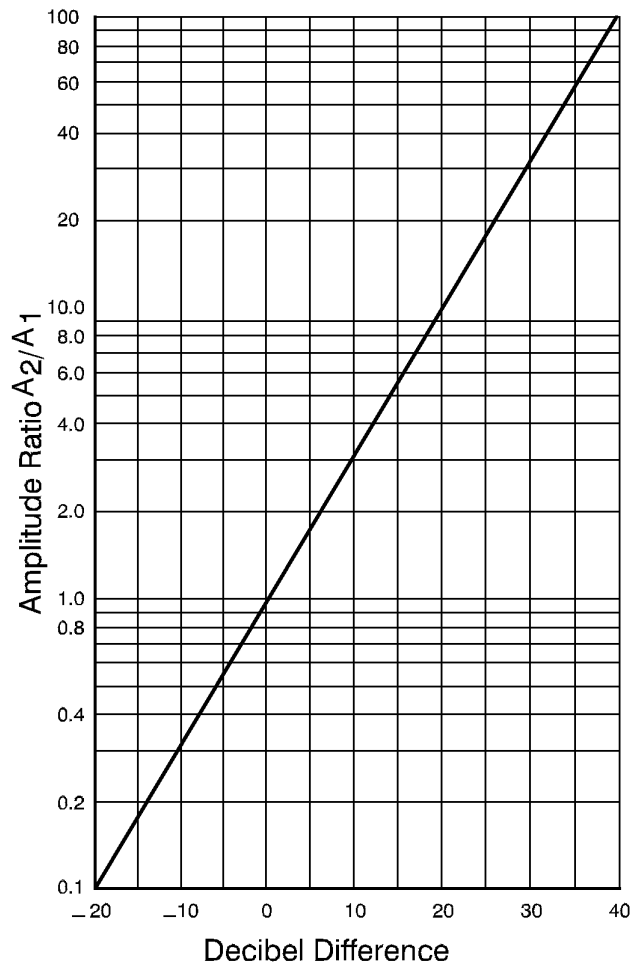
5.3.1.6.1 Receiver Gain. The gain control is used to adjust the amplitude (height) of signals on the waveform display. A positive increase in the gain control will increase the amplitude of the signals; however, on a few instruments the control is actually an attenuation control, with which a positive adjustment will decrease the amplitude of the signals. Some instruments will have both gain and attenuation controls. On most instruments, the gain control is calibrated in terms of the decibel (dB). The decibel is used to express the relationship between two signal amplitudes:

$$\text{dB} = 20 \log_{10}(A_2/A_1)$$

where:

A_2 and A_1 are the two amplitudes that are being compared.

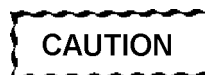
5.3.1.6.1.1 For every 6 dB increase, the amplitude of a signal doubles. Thus, with an 18 dB increase, a signal would have eight times the original amplitude. Conversely, the signal amplitude is cut in half with a decrease of 6 dB. The relationship of dB to the amplitude ratio is shown in [Figure 5-23](#).



H0402834

Figure 5-23. Decibel-to-Amplitude-Ratio Conversion Chart

5.3.1.6.2 Reject.



The REJECT control SHALL NOT be set at or above the rejectable signal threshold because this will cause defects to be missed.

The reject control is used to attenuate irrelevant low-level signals and noise on the waveform display. This often permits easier interpretation of echo signals, but can also obscure wanted signals if applied inappropriately. Most new instruments have lin-

ear reject controls which eliminate the low-level signals without affecting the amplitude of the relevant echo signals. The effect of the linear reject control is illustrated in [Figure 5-24](#).



NOTE
SMALL BASE LINE SIGNALS
HAVE BEEN CLIPPED OFF
PRESENTING A CLEANER
BASELINE

H0402835

Figure 5-24. Reject Control

5.3.1.6.3 **Frequency.** The Frequency control allows the inspector to select the frequency corresponding to a transducer or to select the broadband mode to cover all frequencies. The selection that gives the best echo signal is normally used.

5.3.1.6.4 **Single/Dual Transducer.** This control configures the transducer-cable receptacles for single-element transducer, dual-element transducer, or two separate transducers (through-transmission) inspection. The Dual position of the control is used for both dual-element-transducer and two-transducer inspections; in these cases, some instruments specify one receptacle as transmitter and the other as receiver. For single-element-transducer inspections, only one receptacle is used. Consult the instrument manual or procedure for the appropriate use of the connectors.

5.3.1.6.5 **Electronic Distance Amplitude Correction (DAC).** Distance Amplitude Correction (DAC) MAY also be called STC (Sensitivity Time Control), TCG (Time Corrected Gain), TVG (Time Varied Gain). DAC electronically compensates for material attenuation. Attenuation typically results in decreasing amplitude echoes from equal-size reflectors located at increasing travel distances from the transducer. After DAC is applied over a particular thickness, all the echoes from reflectors of equal size and in the same orientation within that thickness, will be displayed at the same amplitude.

5.3.1.7 **Flaw Gates.** A gate is an electronic feature that allows an inspector to monitor for discontinuities within specific zones of the test part. A gate appears on the display as a short horizontal sweep segment above the baseline. The gate can be adjusted so any signal that appears within the limits of the gate will energize an audible or visual alarm alerting the inspector to a possible flaw that needs to be investigated further. Controls for the gate on the display are as follows.

5.3.1.7.1 **Gate Start.** This control is used to adjust the location of the leading edge of the gate on the display.

5.3.1.7.2 **Gate Width/Length.** This control is used to adjust the width of the gate or the location of the trailing edge of the gate.

5.3.1.7.3 **Threshold/Alarm Level.** This control adjusts the vertical position of the gate trigger level (accept/reject level). A positive gate is defined when a signal triggers the gate as it exceeds the threshold level. A negative gate is defined when a signal triggers the gate as it falls below the threshold level. Often referred to as "Gate Logic" on ultrasonic units, "Positive Logic" is when the alarm is triggered as the signal exceeds the gate and "Negative Logic" is when the alarm is triggered as the signal falls below the gate. Only signals that exceed the level of the gate cause an alarm or a record to be made.

5.3.2 **Transducers.**

CAUTION

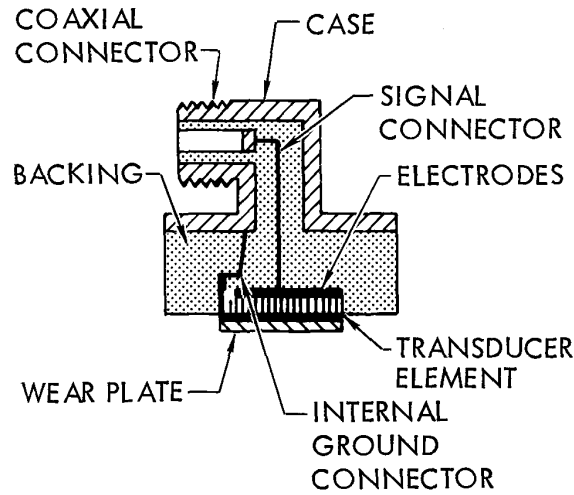
Transducers are fragile and SHALL be handled with care. Sharp blows, caused by dropping or banging a transducer against a surface, could cause extensive damage.

5.3.2.1 **General Description.** Transducers serve to convert electrical energy received from the ultrasonic instrument pulser into acoustic energy through the use of piezoelectric elements. The acoustic energy enters the test piece and returns to the transducer where it is converted back to electrical energy and returned to the ultrasonic instrument for display. Transducers are available in a great variety of shapes and sizes.

5.3.2.2 **Transducer Construction.** The schematic in [Figure 5-25](#) shows the basic parts of a typical straight beam transducer used for contact inspection, while [Figure 5-26](#) schematically shows an angle beam transducer. The backing material, shown in [Figure 5-25](#), serves to damp the ringing of the transducer element after it is excited. This affects the resolution of an inspection as explained in [Paragraph 5.3.2.4.2](#). The plastic wedge, serves to transmit longitudinal waves to the test part surface where mode conversion occurs. Refracted longitudinal, shear, or surface waves (depending on the angle of the plastic wedge) are generated in the test part.

5.3.2.3 **Types of Contact Transducers.** Contact transducers are typically hand-held and manually scanned in direct contact with the inspection piece. A couplant material is required to ensure sound transmission between the transducer and the test piece.

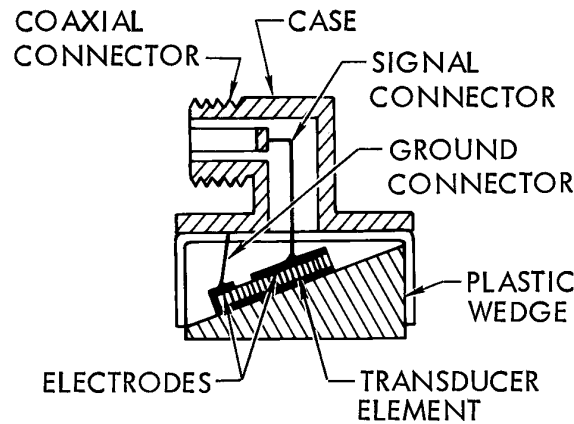
5.3.2.3.1 **Straight Beam.** Straight beam (also known as "0 degree" or "zero degree") transducers are used to launch longitudinal sound beams into a test piece and can be used singularly in a pulse-echo scenario or in tandem for through-transmission or pitch-catch techniques. Typically straight beam transducers are used in a pulse-echo mode detecting laminar discontinuities with surfaces lying parallel with the inspection surface. The basic parts of a typical straight beam transducer used for contact inspection are schematically shown in [Figure 5-25](#).



H0402836

Figure 5-25. Straight Beam Contact Transducer

5.3.2.3.2 Angle Beam. Angle beam transducers are used to launch shear wave sound beams into a test piece and are typically used in a pulse-echo scenario. Typical uses for angle beam transducers include tube, plate, or pipe welds or anywhere there is a need to launch a sound wave at other than parallel to the test piece surface. An angle beam transducer is schematically shown in Figure 5-26. The plastic wedge serves to transmit longitudinal waves to the test part surface where mode conversion occurs. Refracted longitudinal, shear, or surface waves (depending on the angle of the plastic wedge) are generated in the test part.



H0402837

Figure 5-26. Angle Beam Contact Transducers

5.3.2.4 Transducer Sensitivity and Resolution.

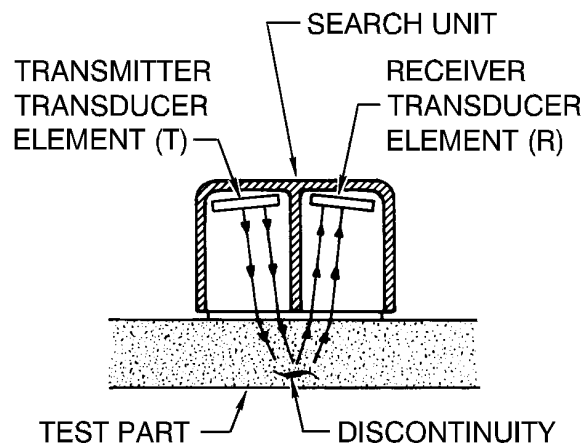
5.3.2.4.1 Sensitivity. Sensitivity is the ability of an inspection system to detect small discontinuities. It is generally rated by the ability to detect a specified size and depth of a flat-bottom hole in a standard test block. Sensitivity is unique to each

combination of transducer and test instrument. The ability to detect small discontinuities is typically increased by using a higher frequency (shorter wavelength) although penetrating power is sacrificed.

5.3.2.4.2 Resolution. Resolution refers to the ability of an inspection system to separate (distinguish) signals from two interfaces close together in depth. An example of two such signals is the front surface signal and the signal from a small discontinuity just beneath the surface. The damping or backing material affects the time required for the transducer to stop “ringing” after being excited by a pulse from the test instrument. Low damping causes high “ringing” resulting in a wide, high-amplitude front surface signal. This would cause a long dead zone and a subsequent loss of resolution. Generally, resolution improves with a higher frequency.

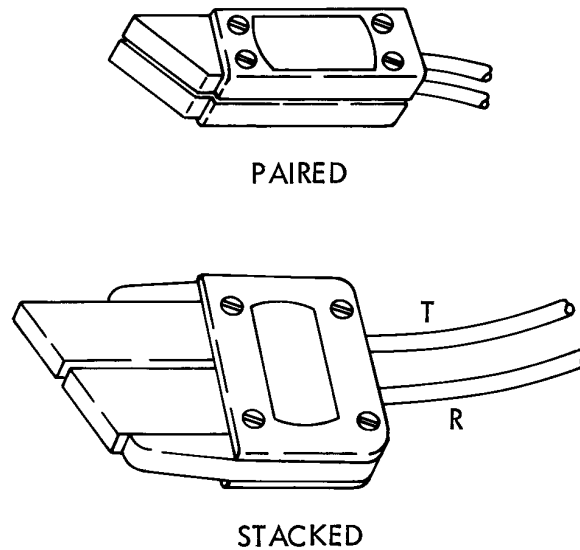
5.3.2.5 Transducer Shape and Size. The variety of sizes and configurations of transducers that can be used is almost endless. Transducer faces can be round or rectangular. Transducers 1/8-inch diameter and smaller have been used.

5.3.2.6 Dual Transducers. Dual transducers are used primarily in applications where good near-surface resolution is required. Ultrasonic thickness measurement instruments commonly use dual transducers. The operation of a typical dual transducer is shown in [Figure 5-27](#). The spaces under the transducer elements are usually filled with plastic material that serves as a delay line. Thus, the initial pulse does not interfere with any echoes from the near surface of the test piece. Dual transducers are also used in angle beam inspection. Two types of angle beam dual transducers are shown in [Figure 5-28](#).



H0402838

Figure 5-27. Dual Transducer Operation



H0402839

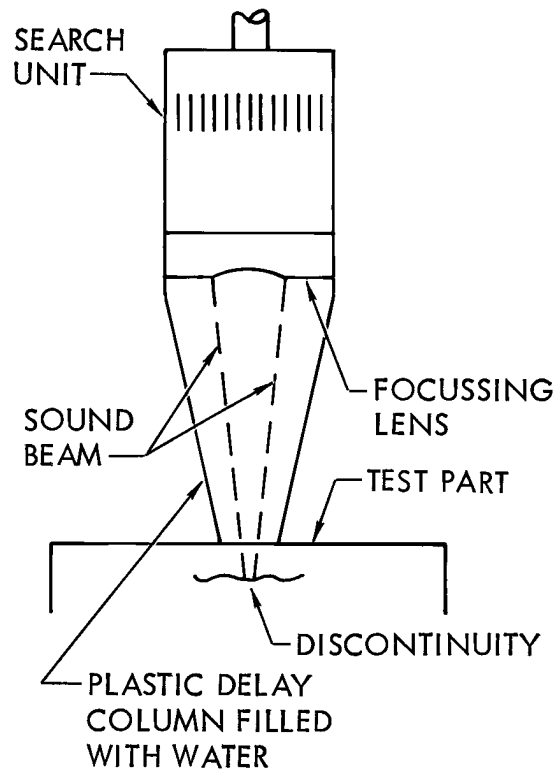
Figure 5-28. Angle Beam Dual Transducers

5.3.2.7 **Wear Faces.** Transducers are often fabricated with removable plastic or rubber wear faces. These faces improve coupling on rough surfaces and prevent wear of the transducer face; however, the flexible wear faces reduce the amount of power available from the transducer.

5.3.2.8 **Delay Lines.** A transducer may have a solid, or a fluid delay line. Delay lines move the part surface out of the dead zone, thereby improving near-surface resolution. Because of the increased resolution, delay lines are used extensively for thickness measurements and other applications that require a high degree of resolution.

5.3.2.8.1 **Solid Delay Line.** A solid delay line may be an integral part of the transducer or may be removable. An integral delay line is bonded to the transducer element. A removable delay line requires a couplant between it and the transducer face. Various lengths of removable delay lines can be interchanged and can be replaced when worn.

5.3.2.8.2 **Fluid Delay Line.** Some transducers are equipped with water delay columns. The water column also permits the use of focused transducers. The delay line can either have an open bottom requiring a rapid flow of water to maintain coupling, or it can be equipped with a thin membrane at the bottom. This form is common in large automated scanning systems. The membrane is usually punctured in the middle to provide a slow flow of water for coupling. Water delay lines with flowing water are also called "bubblers" or "squirters." A variety of sizes are used. Fluid delay lines provide the same advantages in resolution as solid delay lines.

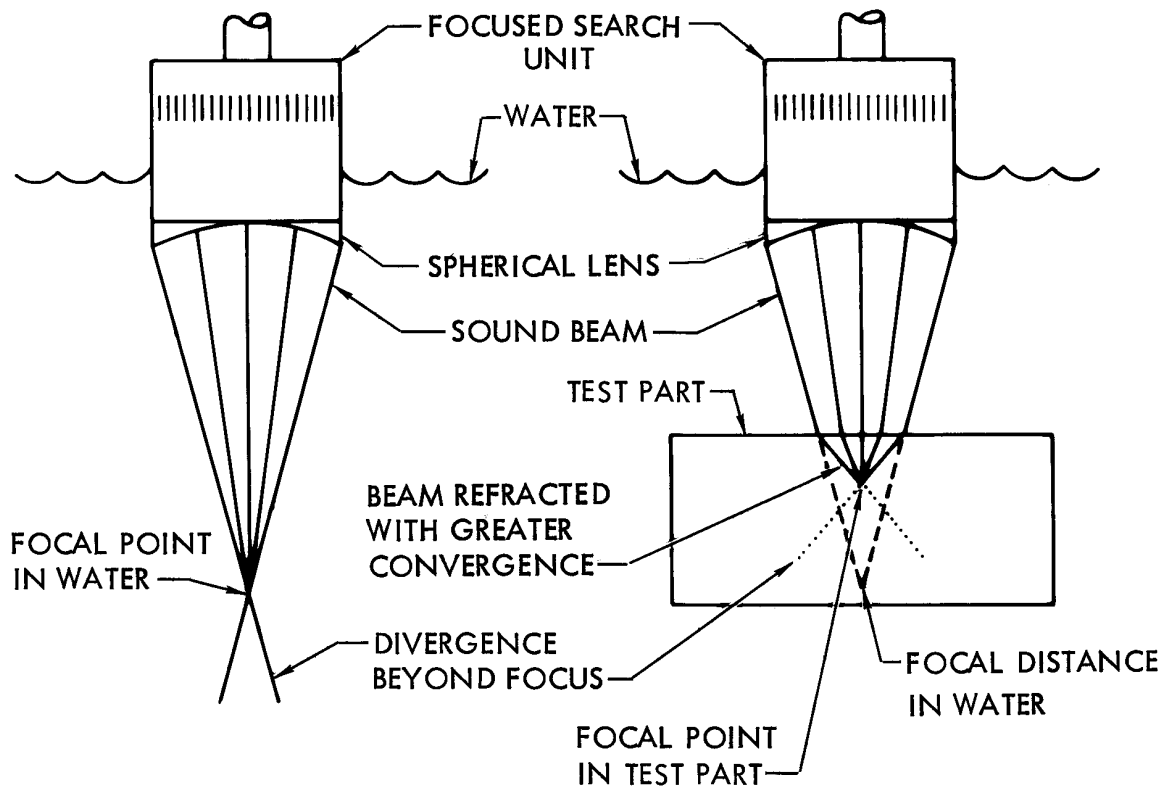


H0402840

Figure 5-29. Water Delay Column Transducers

5.3.3 Specialized Transducers.

5.3.3.1 Focused Sound Beams. On some immersion inspections ([Paragraph 5.4.2.1.1.2](#)) or special contact tests with a water delay column, a focused sound beam is used ([Figure 5-29](#)). As shown in [Figure 5-30](#), the focusing is produced by using a transducer containing a plastic acoustic lens on the face of the transducer element. The acoustic lens causes the sound beam to converge as the sound travels away from the transducer. Due to refraction at the plastic-water interface, a peak in amplitude is obtained at the focal point. The amplitude then decreases rapidly on each side of this point. This type of transducer has a high sensitivity for discontinuities located at the focal point distance due to the concentration of energy at this focal point, but the depth of material inspected in any one scan is limited. Beam shaping, which “tucks in” the side lobes can also be accomplished by using an acoustic lens without creating a focused transducer.

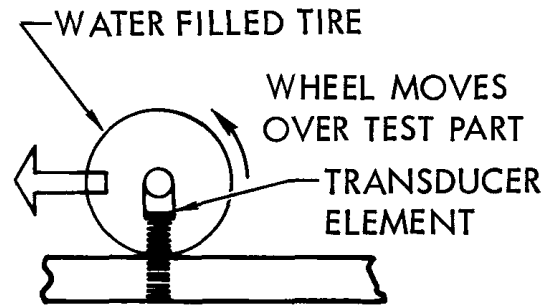


NOTE:
 DUE TO THE REFRACTION AT THE WATER TO TEST PART INTERFACE,
 THE FOCAL DISTANCE IS SHORTENED IN THE TEST PART .

H0402826

Figure 5-30. Focused Sound Beams

5.3.3.2 Wheel Transducers. A wheel search unit operates much like an immersion probe and consists of a flexible tire filled with liquid and containing one or more transducer elements. As shown in [Figure 5-31](#), sound is transmitted through the liquid, the tire, and into the part through a thin couplant film between the tire and the part. Wheel search units can be used for straight beam and angle beam applications and are most advantageous for large area scanning of plate or other flat stock material.



H0402841

Figure 5-31. Wheel Transducer

5.3.3.3 Paint Brush or Array Probes. Large-area inspections can sometimes be made easier by use of a paint-brush probe. These probes are made up of an array of transducers or crystals in an extended length that allows a wide inspection area to be covered with one scan. The crystals that make up the array must be matched such that the beam intensity does not vary greatly over the length of the probe.

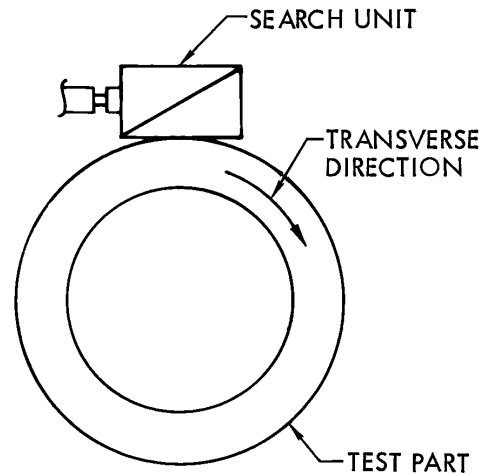
5.3.3.4 Collimators. Transducers can be equipped with collimators to reduce the size of the sound beam entering the test part. The collimator may be a solid cone (usually acrylic plastic) bonded to the face of the transducer. This type of collimator reduces the diameter of the sound beam entering the test part to the diameter of the tip of the cone. The cone also acts as a delay line and can result in better near surface resolution. However, this type of collimator reduces the energy entering the test part. Hollow cylindrical collimators MAY also be used in immersion inspections in which the collimator is attached to an immersion transducer to control the beam shape.

5.3.4 Wedges and Shoes. Wedges and shoes are used to adapt transducers for angle beam and surface wave inspections and for inspecting parts with curved surfaces. If flat probes are used on convex surfaces, the ultrasonic energy transmitted into the part is drastically reduced, because only the center of the transducer makes good contact with the part. Flat transducers of small size (1/4-inch or less diameter or width) can be used in some cases on convex surfaces down to 1.5-inch radius. However, loss of power results due to the smaller contact area. Inspections performed with flat-faced transducers on curved surfaces will be hindered by the tendency of the transducer to rock ([Figure 5-32](#)). This varies the angle of the incident and refracted sound beam and causes problems in interpretation.

5.3.4.1 Guidelines for Use of Curved Wedges and Shoes.

5.3.4.1.1 Wedges and shoes SHALL be used on all convex surfaces with a radius of curvature of 1.5-inches or less. They SHOULD be used on all convex surfaces with a radius of curvature between 1.5 and 4.0-inches.

5.3.4.1.2 Wedges and shoes SHALL be used on all concave surfaces with a radius of curvature or less than 4-inches.



NOTE
FLAT SURFACE OF SEARCH UNIT MAKES
SEARCH UNIT UNSTEADY, COULD
CAUSE ROCKING BACK AND FORTH.
THIS CHANGES INCIDENT AND
REFRACTED ANGLES.

H0402842

Figure 5-32. Angle Beam Inspection of Curved Surface Using Flat Transducer

5.3.4.2 Design and Fabrication of Wedges and Shoes.

CAUTION

- Field units SHALL NOT manufacture shoes and/or wedges unless specifically directed by TO or other approved written procedure. If authorized, the procedure SHALL provide material requirements and detailed dimensional requirements.
- Excessive heat, generated during fabrication (machining or sanding), of acrylic plastic wedges and delay elements, MAY significantly increase the attenuation of ultrasound in this material.

5.3.4.2.1 Plastic wedges and shoes can be fabricated from Lucite, polystyrene, or other acrylic (Item Grade C plastic of Federal Specification L-P-391) plastics. Some plastics will scatter ultrasonic energy; so before using a plastic, a sample SHALL be checked to ensure sound can be adequately transmitted through the material. The sample SHALL be at least as thick as the wedge or shoe to be fabricated. Check the sample using a straight beam ([Paragraph 5.3.2.3.1](#)) inspection and the highest frequency that will be used with the completed wedge or shoe, and note the back reflection signal. If a strong back reflection (at least 100-percent saturation) cannot be obtained with a reasonable gain setting, new material SHALL be procured and checked.

5.3.4.2.2 Angle beam wedges MAY be fabricated according to [Figure 5-33](#) or [Figure 5-35](#). The wedge in [Figure 5-33](#) has provisions built in for mounting the straight-beam transducer, while the wedge in [Figure 5-35](#) requires a coupling fixture [Figure 5-34](#) for mounting the straight-beam transducer. Similar fixtures MAY be procured or locally manufactured. The incident angle, " Φ_1 ", for each wedge SHALL be determined by using Snell's law and the respective velocities of the wedge, test material and the refracted angle, " Φ_2 ", required by the inspection procedure. Values for " Φ_1 ", calculated for listed refracted angles in materials are contained in [Table 5-8](#).

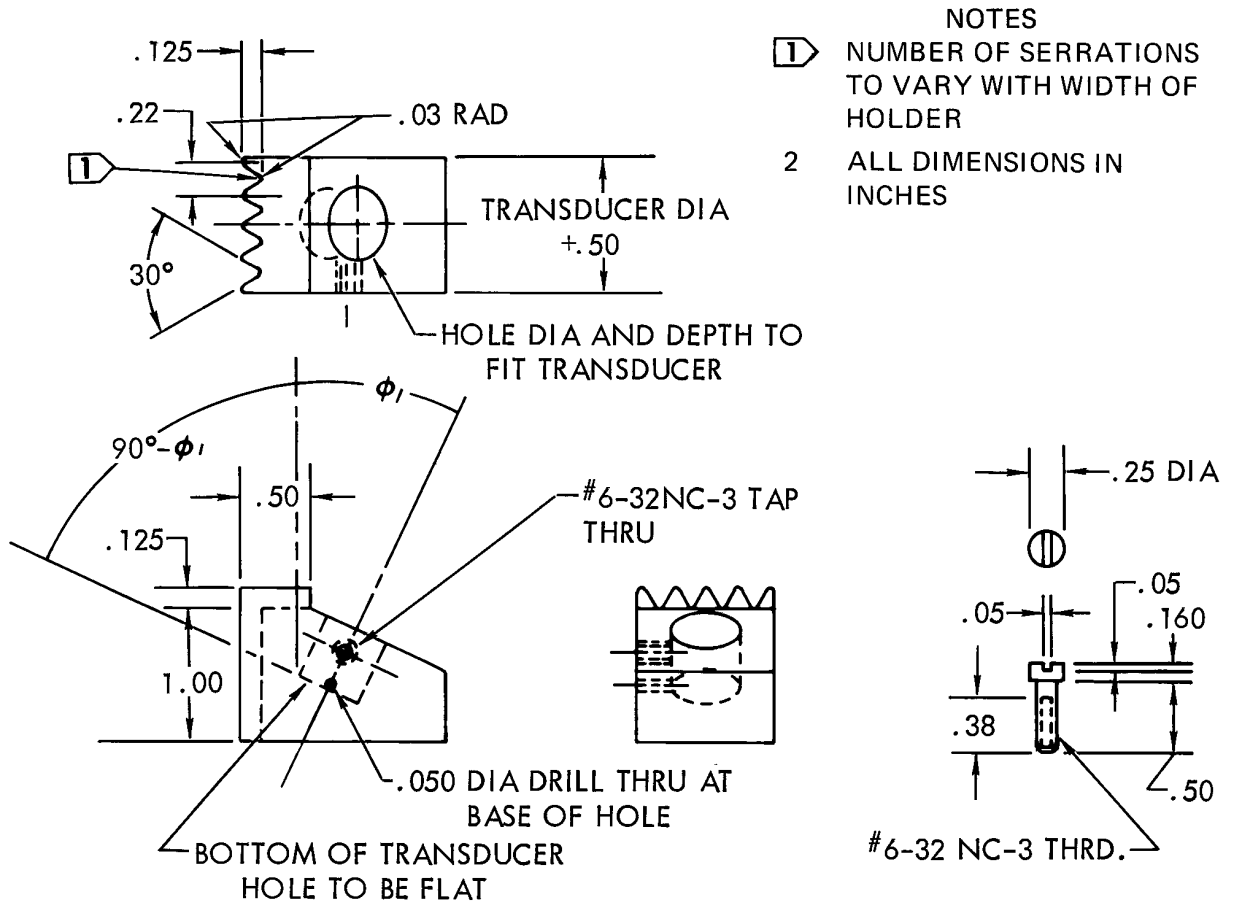
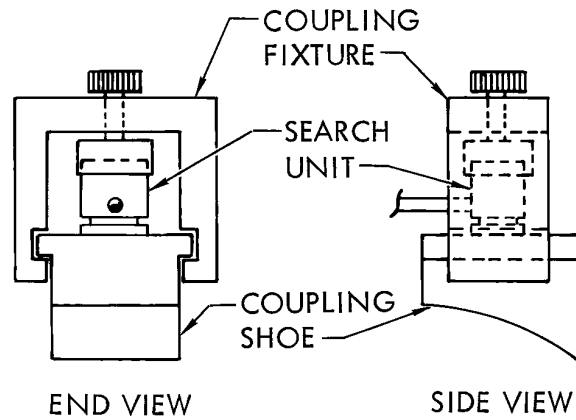


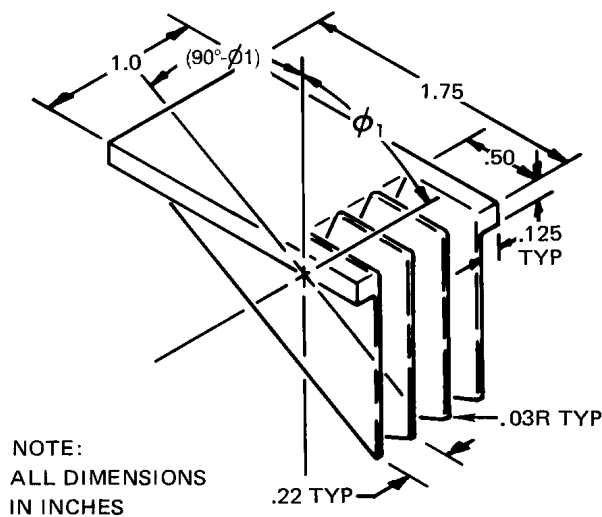
Figure 5-33. Angle Beam Wedge With Hole for Mounting Transducer

H0402843



H0402862

Figure 5-34. Use of a Coupling Fixture to Hold Transducer on Shoe



H0402865

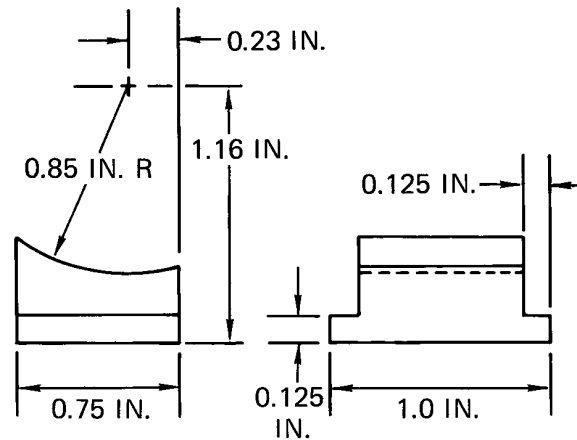
Figure 5-35. Angle Beam Wedge Requiring a Coupling Fixture

5.3.4.2.3 Notice the serrations on the wedges in [Figure 5-33](#) and [Figure 5-35](#). These serve to dampen and scatter reflected sound that does not initially enter the test part. The serrations, therefore, reduce false signals.

5.3.4.2.4 The configurations of the wedges in [Figure 5-33](#) and [Figure 5-35](#) MAY be modified as required to take care of special geometry situations. In all cases, wedges SHALL be fabricated to provide the proper refracted angle for the desired mode of vibration. In addition, they SHALL provide for transmission of sound into the test part at the locations required to cover the areas of suspected flaws.

5.3.4.2.5 Look at [Figure 5-34](#) to see how the coupling fixture is used with the wedge in [Figure 5-35](#). A few drops of couplant material is needed between the transducer and any wedge to ensure good sound transmission.

5.3.4.2.6 A typical shoe used for curved surfaces is shown in [Figure 5-36](#). This example MAY be used as a guideline for fabrication of shoes for curved surfaces. Dimensions MAY be changed to accommodate the specific part to be inspected.



NOTE
 DIMENSIONS MAY BE CHANGED
 TO ACCOMMODATE THE CONFIG-
 URATION TO BE INSPECTED
 AND PROVIDE THE PROPER
 SOUND ENTRY ANGLES.

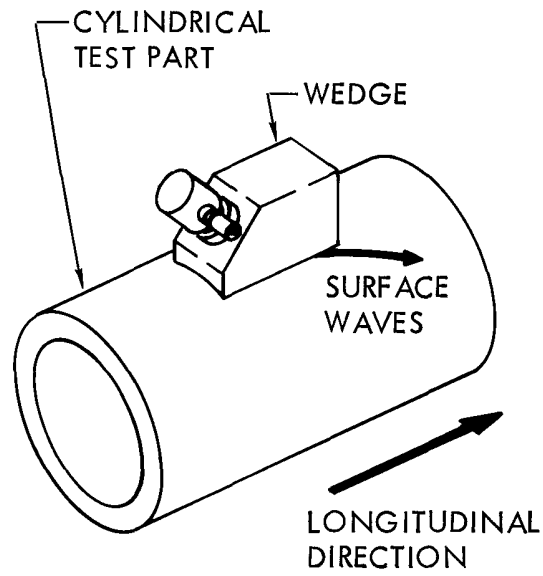
H0402864

Figure 5-36. Typical Curved Surface

5.3.4.2.7 Although shoes for curved surfaces are usually fabricated from acrylic plastic, sometimes shoes are fabricated from the same material as the test part. When using shoes of the same test part material, the sound beam travels straight into the test part from the shoe; refraction does not occur.

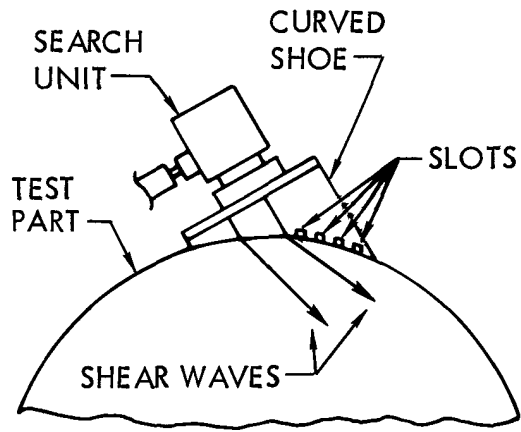
5.3.4.2.8 The radius of curvature of each shoe SHOULD match the radius of curvature of the test part. Small changes in the curvature of the shoe can be accomplished on the test part by inserting number 400 or finer grit sandpaper between the shoe and the test part, and then sliding the shoe across the sandpaper. Major shaping of a shoe SHOULD be done in a machine shop, because the shoe cannot be held steady enough by hand.

5.3.4.2.9 In some cases, when using plastic shoes for angle beam inspection on curved surfaces, the portion of the sound beam (away from the beam center) could produce unwanted longitudinal and/or surface waves as shown in [Figure 5-39](#). This effect increases with decreasing radii of curvature. Also, when using large angles (70° or larger) for inspecting cylindrical shapes in the longitudinal direction, interfering surface waves could be generated. These waves leave the shoe on both sides at an angle to the longitudinal direction ([Figure 5-37](#)). In these cases, it is not desirable to adapt the shoe to a close fit with the part. The shoe SHOULD be made so only the central portion of the beam centers the test part. As an option, slots MAY be cut in the bottom surface of the shoe. The slots SHOULD be oriented perpendicular to the direction of propagation of the unwanted surface waves and located away from the exiting beam center ([Figure 5-38](#)). The dimensions of the slots SHOULD be about 1/8-inch wide by 1/8-inch deep.



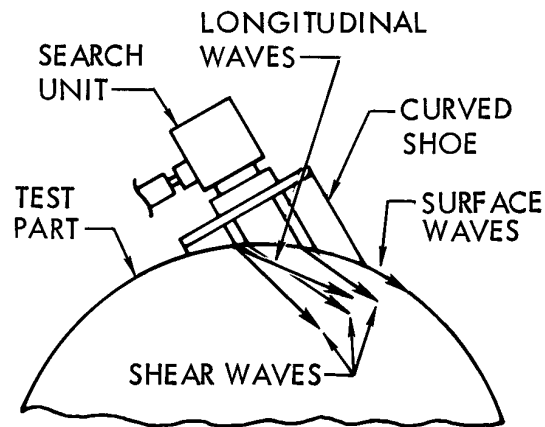
H0402866

Figure 5-37. Generation of Unwanted Surface Waves During Inspection of Cylindrical Part in the Longitudinal Direction



H0402867

Figure 5-38. Slots in Shoe to Eliminate Unwanted Surface Waves



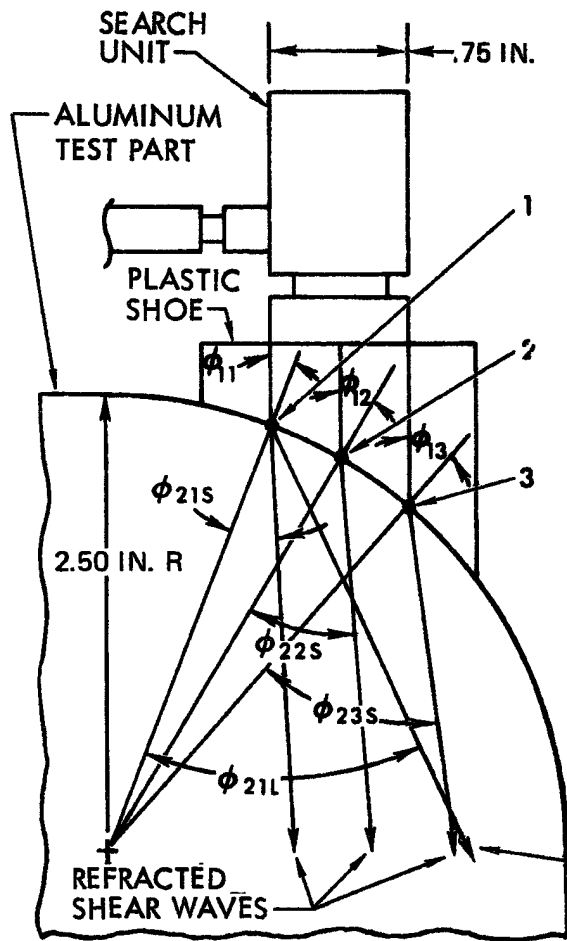
H0402868

Figure 5-39. Generation of Unwanted Longitudinal and Surface Waves on Curved Surface

NOTE

Unwanted surface waves can be detected by noting additional unexpected signals on the waveform display. If these signals can be damped and traced to their source using an oil-wetted finger, as explained in [Paragraph 5.4.6.4.3](#) step c, unwanted surface waves are being generated.

5.3.4.2.10 When designing shoes for curved surfaces, the sound beam path in the shoe and the test part SHALL be considered in order to ensure coverage of the area of interest within the test part. Generally, the sound beam path in the shoe can be considered to be a straight projection of the transducer face; in almost all cases the sound travel in the shoes will be in the near field and characterized by no beam spread. The beam path in the part can be obtained by using Snell's Law ([Paragraph 5.2.4.1](#)) and [Figure 5-40](#) to determine the refracted angle at various points across the sound beam where it enters the test part surface.



NOTES
 LONGITUDINAL WAVES ARE NOT REFRACTED FROM POINTS 2 AND 3 BECAUSE ϕ_{12} AND ϕ_{13} ARE GREATER THAN THE FIRST CRITICAL ANGLE.

ϕ_{11} , ϕ_{12} , ϕ_{13} DESIGNATE THE INCIDENT ANGLES OF LONGITUDINAL WAVES AT POINTS 1, 2, AND 3 RESPECTIVELY.

ϕ_{21s} , ϕ_{22s} , ϕ_{23s} DESIGNATE THE REFRACTED SHEAR WAVE ANGLES FROM POINTS 1, 2, AND 3 RESPECTIVELY.

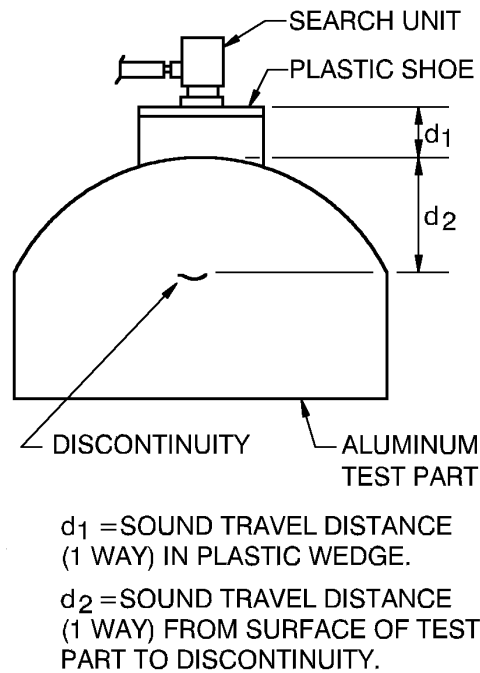
ϕ_{21L} DESIGNATES THE REFRACTED LONGITUDINAL WAVE ANGLE FROM POINT 1.

$\phi_{11} = 19.5^\circ$, $\phi_{12} = 30^\circ$ AND $\phi_{13} = 40.5^\circ$. THE REFRACTED BEAM ANGLES DETERMINED BY SNELL'S LAW ARE: $\phi_{21s} = 23^\circ$, $\phi_{22s} = 35.5^\circ$, $\phi_{23s} = 51.5^\circ$, $\phi_{21L} = 51.5^\circ$.

H0402869

Figure 5-40. Example of Determining the Sound Beam Path in a Test Part With a Curved Surface

5.3.4.2.11 With certain inspection setups, particularly when using shoes to generate straight beams (Paragraph 5.3.2.3.1) in parts with curved surfaces, multiple reflections from the shoe-to-test part interface can interfere with the inspection. To avoid this, the shoe SHALL be made thick enough to avoid interference with the intended inspection application. Consider the inspection setup shown in Figure 5-41. It is important only that the inspector be able to recognize and identify indications on the waveform display. Reflections caused by the shoe are easily recognized simply by raising the shoe off the surface of the material. If the indications remain on the screen, the plastic shoe is the cause. Slotting the shoe as shown in Figure 5-38 may reduce or eliminate such interference signals. It is not necessary for the operator to calculate the sound paths to and from various reflectors; however, it is important the operator know how to recognize non-relevant indications from the reflectors and minimize their cause.



H0402870

Figure 5-41. Straight Beam Inspection of Test Part With Curved Surface

5.3.5 Couplants.

CAUTION

“Ultragel” cannot be left on transducer/delay line interfaces for long periods of time because it will corrode the metallic finish of the transducer, seize the connecting ring and transducer housing causing the transducer to become unstable.

NOTE

Glycerin, silicones, and graphite greases SHALL NOT be used as couplants unless authorized by specific engineering approval.

Air is a poor transmitter of sound at the frequencies typically used for ultrasonic inspection. Therefore, to perform ultrasonic contact inspection ([Paragraph 5.4.2.1.1.1](#)) the use of a couplant material is necessary to eliminate the air between the transducer and test piece interface.

5.3.5.1 Properties of Couplants. Couplant materials SHALL meet the following requirements:

- Couplant SHALL be able to wet both the face of the transducer and the test part.
- Couplant SHALL NOT be corrosive or toxic.
- Couplant can be applied and removed easily.
- Couplant SHALL be homogeneous and free of bubbles.
- Couplant SHALL be viscous (adhere well) enough to prevent rapid flow off the test part.

5.3.5.2 Types of Couplant. Typical couplant materials include water, oil, grease, commercial gels. For overhead or vertical surfaces, higher viscosity materials may be required. Wetting agents MAY be added to water to lower the surface tension and aid in its adherence to the test piece. Water SHOULD be avoided on carbon steel components to prevent corrosion. Petroleum based couplants SHOULD be avoided on fibrous composite materials to prevent adhesive/matrix degradation.

5.3.6 Inspection Standards. To ensure consistency of inspections from inspector to inspector many ultrasonic inspection techniques require the use of a reference standard for setup and/or calibration. The use of an inspection standard allows the operator to adjust the ultrasonic instrument controls properly, ensuring that the combination of ultrasonic instrument and transducer meets the specified sensitivity requirements. Standards can be locally manufactured to specific engineering instructions, an actual failed in-service component, or any one of numerous standard reference blocks.

5.3.6.1 Standard Reference Blocks. These are blocks, whose dimensions have been sanctioned and/or required by professional organizations or commercial codes (e.g., ASME, IIW, AWS, ASTM). Only the most likely used standard reference blocks are described here.

5.3.6.1.1 Area-Amplitude Blocks. The area-amplitude blocks are intended to establish the correlation between the signal amplitude with the area of a flat bottom hole reflector. These sets of blocks contain flat-bottom holes of differing diameters all at the same distance from the sound entry surface.

5.3.6.1.2 Distance-Amplitude Blocks. The distance-amplitude blocks are intended to establish the correlation between the signal amplitude with the corresponding distance to a flat bottom hole reflector. These sets of blocks contain flat-bottom holes of the same diameter all at varying distances from the sound entry surface.

5.3.6.1.3 American Society of Testing and Materials (ASTM) Standard Reference Block Set. Each Air Force NDI laboratory SHALL possess an aluminum alloy ASTM standard reference block set (or AF NDI Office approved equivalent). The dimensions for all ASTM blocks are specified in ASTM E127, which also includes recommended practices for fabrication and control of the aluminum alloy reference blocks. ASTM E428 contains the recommended practice for fabrication and control of the steel standard reference blocks.

5.3.6.1.3.1 The basic ASTM block set includes ten, 2.0-inch diameter blocks of the same material stock. Each block has a 0.75-inch deep flat-bottom hole (FBH) drilled in the center of the bottom surface. One block has a 3/64-inch diameter hole at a 3-inch metal travel distance. Seven blocks have 5/64-inch diameter holes at metal travel distances of 1/8, 1/4, 1/2, 3/4, 1.5, 3.0 and 6.0-inches. The remaining two blocks have 8/64-inch diameter holes at 3.0 and 6.0-inches metal travel distances. Each block is identified by a nine-digit code (AAAA-B-CCCC). The first four digits identify the material alloy, the center digit is the diameter of the hole in 1/64-inch, and the last four digits are the metal travel distance from the top surface to the hole bottom in 1/100 inch. For example, the block marked 7075 8 0300 is 7075 aluminum and has an 8/64-inch diameter hole with a 3.0-inch metal travel distance.

5.3.6.1.3.2 The three blocks with 3.0-inch metal travel and 3/64, 5/64 and 8/64-inch are utilized as an area-amplitude set. The seven blocks with #5 (5/64-inch) flat-bottom holes are utilized as a distance-amplitude set.

5.3.6.1.4 International Institute of Welding (IIW) Blocks. Each Air Force NDI laboratory SHALL possess an aluminum alloy and steel, Type 2 IIW standard reference block (or AF NDI Office approved equivalent). The material and dimensional requirements of the IIW blocks are specified by the International Institute of Welding. The Type 2 IIW Blocks are primarily used for measuring the beam exit point and refracted angle of angle beam transducers and for calibrating angle beam metal path distances. Straight beam distance resolution, distance calibration, and near and far surface resolution can also be accomplished with use of certain known notches and block distances.

5.3.6.1.5 Miniature Angle Beam Block. The miniature angle beam block is a smaller and lighter version of the Type 2 IIW block and can be used for the same purpose. However, near and far surface resolution checks CANNOT be performed with the miniature angle beam block.

5.3.6.2 Locally Manufactured Standards. Where locally manufactured standards are specified in a procedure, specific engineering instructions SHALL be provided that detail the manufacturing requirements. Typical ultrasonic standard manufacturing requirements include flat-bottom holes, side-drilled holes, and EDM notches. Flat-bottom holes are used for area-amplitude type calibrations. Side-drilled holes are used for developing distance-amplitude correction (DAC) curves. EDM or other type notches are used to determine the sensitivity to surface breaking flaws such as cracks. Thickness measurement requirements may require the manufacture of step-wedges or other specific thickness components.

5.3.7 Bonded Structure Reference Standards.

5.3.7.1 Configuration. The reference standard MAY be a duplicate of the test part except for the controlled areas of unbond. As an option, simple test specimens which represent the respective different areas of the test part and contain controlled areas of unbond MAY be used. Reference standards SHOULD:

- Be similar to the test part with respect to material, geometry, and thickness. (This includes closure members, core splices, stepped skins, and internal ribs similar to the test part if bonded areas over or surrounding base details are to be inspected.)
- Contain bond(s) of good quality except for controlled areas of unbond fabricated as explained below.
- Be bonded using the adhesive and cure cycle prescribed for the test part.

5.3.7.2 Defect Types. Defects are separated into five general types to represent the various areas of bonded sandwich and laminate structures. The five general types are:

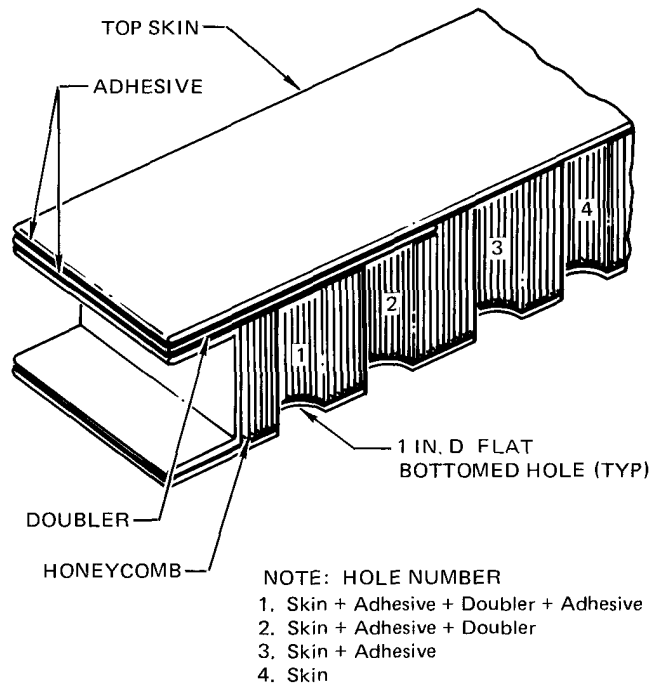
- Type I: Unbonds or voids in an outer skin-to-adhesive interface.
- Type II: Unbonds or voids at the adhesive-to-core interface.
- Type III: Delaminations or voids between layers of a laminate.
- Type IV: Voids in foam adhesive or unbonds between the adhesive and a closure member at core-closure member joints.
- Type V: Water in the core.

5.3.7.3 Fabrication of Bonded Reference Standards. The reference standards SHALL contain unbonds equal to the sizes of the minimum rejectable unbonds for the test parts. Information on minimum rejectable unbond sizes for test parts SHALL be obtained from the prime depot level engineering activity.

5.3.7.3.1 Producing unbonds by use of grease, vinyls, and other foreign material not covered below is prohibited. One or more of the following techniques SHALL be used in fabricating reference defects. Since bonding materials vary, some of the methods may not work with certain materials.

5.3.7.3.2 Standards for Types I, II, III, and IV unbonds MAY be prepared by placing discs of 0.006-inch thick (maximum) Teflon sheets over the adhesive in the areas selected for unbonds. For a Type-II unbond, place the Teflon between the core and adhesive. Assemble the components of the standard and cure the assembly.

5.3.7.3.3 Types I, II, and III standards MAY also be produced by cutting flat-bottomed holes of diameter equal to the diameter of the unbonds to be produced. The holes are cut from the backsides of bonded specimens, and the depths are controlled to produce air gaps at the applicable interfaces ([Figure 5-42](#)). When using this method, patch plates MAY be bonded to the rear of the reference standard to cover each hole and seal the reference standard.



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Figure 5-42. Example of Reference Standard for Types I and II Unbonds

5.3.7.3.4 Type II standards MAY be produced by locally undercutting (before assembly) the surface of the core to the desired size unbond. The depth of undercut SHALL be sufficient to prevent adhesive flow, causing bonds between the undercut core and the skin.

5.3.7.3.5 Type IV standards MAY be produced by removing adhesive in selected areas prior to assembly.

5.3.7.3.6 Type V standards MAY be produced by drilling small holes in the back of the standard and injecting varying amounts of water into the cells with a hypodermic needle. The small holes can then be sealed using a small amount of water-resistant glue or adhesive.

5.3.8 Thickness Measurement Equipment. A written procedure SHALL specify equipment, transducer, reference standard, and calibration requirements.

5.3.8.1 Thickness Measurement Instruments. Some ultrasonic instruments are designed specifically for thickness measurements and typically have a digital read-out. Some basic ultrasonic instruments also have built-in thickness measurement options. Detailed instructions for performing thickness measurement with these instruments MAY be obtained by consulting the specific instrument manual.

5.3.8.2 Thickness Measurement Transducers. Transducers for thickness gauging are highly damped for a very short duration pulse for best resolution. With general purpose flaw detectors, best results will usually be obtained by using transducers specifically designed for thickness gauging. Typically, transducers with a narrow dead zone and superior near-surface resolution are required for measurement of thin materials. Therefore, dual-element transducers/search units with delay lines are routinely used. For measurements of thicker materials, a conventional straight beam contact transducer MAY be sufficient. Instruments dedicated to thickness measurements are often supplied with compatible transducers. These often have unique connectors to ensure only dedicated probes are used. Transducers recommended by the instrument manufacturer SHALL be used with dedicated thickness measurement instruments. With a dual-element transducer, the ringing of the transducer element is not detected by the instrument; therefore, received signals close to the initial pulse can be clearly resolved. Dual-element transducers are limited in how thin they can measure by virtue of the elements being side-by-side. A plastic delay line

coupled to the face of a single-element transducer separates the initial pulse from the front surface signal; this improves near-surface resolution (e.g., shortens the dead zone).

5.3.8.3 Thickness Measurement Reference Standards. Reference standards are required to calibrate the instruments prior to thickness inspection ([Paragraph 5.7.8](#)). The material and heat treat condition of the reference standards SHOULD be the same as the test part. The sound velocity in the reference standard SHALL be the same, within acceptable tolerances, as in the part being measured or a correction factor SHALL be used. Thickness measurements of curved and radiused parts may require reference standards with the same curvature. In addition, transducers with curved wedges/shoes to match the contour of the part may be required.

SECTION IV ULTRASONIC INSPECTION APPLICATION

5.4 INTRODUCTION.

5.4.1 Guidelines for Inspector Familiarization. Familiarization with the methods and equipment can be obtained by:

- Performing the familiarization tests included in the instrument manuals.
- Performing the calibration procedures.
- Making distance amplitude correction (DAC) curves ([Paragraph 5.4.8](#)) and establishing transfer ([Paragraph 5.4.9](#)) on some specimens.
- For surface wave familiarization, ([Paragraph 5.4.8.1](#)).

5.4.1.1 All familiarization tests and procedures SHOULD be followed in detail by new inspectors. It is recommended the procedures be run through several times. The inspector SHOULD experiment with various combinations of specimens and transducers to become familiar with different ultrasonic inspection procedures and equipment.

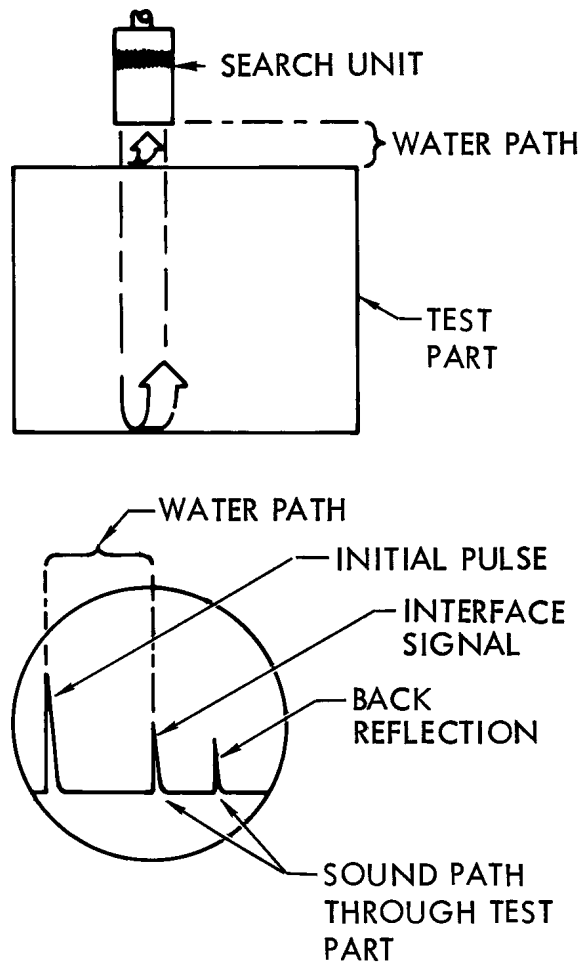
5.4.2 Basic Ultrasonic Inspection.

5.4.2.1 Coupling Methods.

5.4.2.1.1 Contact and Immersion Testing. The transducer must be adequately coupled to the test piece to ensure adequate sound transmission. Coupling is accomplished either through direct contact with the test piece or through a fluid interface between the transducer and the test piece. Thus, coupling methods can be separated into two basic categories: contact inspection and immersion inspection.

5.4.2.1.1.1 Contact Inspection. Contact Inspection is the method in which the transducer makes direct contact with the material. The contact method requires the use of a couplant to ensure sufficient ultrasonic energy transmission into the part. The couplant is an approved substance (usually a liquid) applied as a thin film between the transducer face and the test piece.

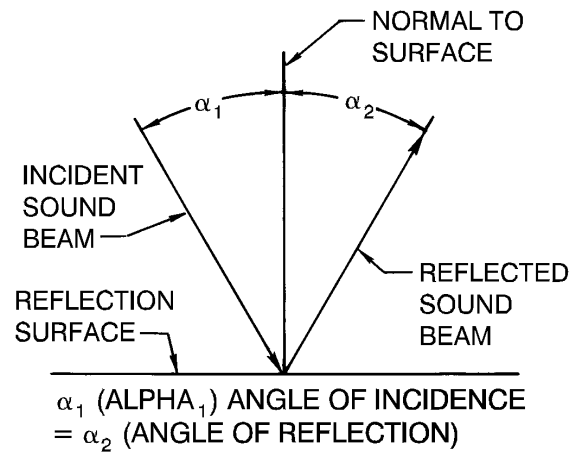
5.4.2.1.1.2 Immersion Inspection. Immersion inspection is an examination method where the transducer and the material are submerged in a tank of water as shown in [Figure 5-43](#). In some instances, a water column is maintained between the transducer and test material. In either case, the water must be free of air bubbles and other foreign material that could interfere with ultrasonic tests. If necessary, corrosion inhibiting agents and wetting agents MAY be added to the water to inhibit corrosion and to reduce the formation of air bubbles on the material and transducer surfaces. Immersion inspections are no longer confined to a tank of water in a laboratory or factory. Bubblers, squirters, and water columns enable the use of immersion techniques with portable ultrasonic scanning equipment in field inspections.



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Figure 5-43. Immersion Method

5.4.3 Ultrasonic Reflections. Ultrasonic sound beams have properties similar to light beams. For example, when an ultrasonic beam strikes an interrupting object, sound beam energy is reflected from the surface of the interrupting object. The angle of incidence is equal to the angle of reflection ([Figure 5-44](#)).

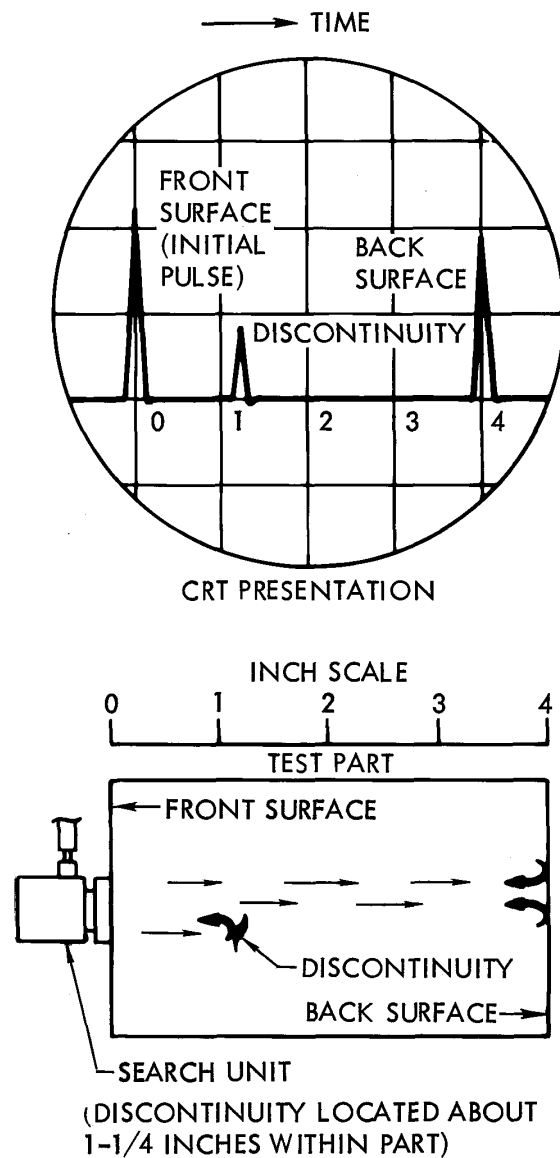


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Figure 5-44. Ultrasonic Reflection

5.4.4 Data Presentation Methods. There are three methods of data presentation used for ultrasonic inspection: A-scan, B-scan, and C-scan.

5.4.4.1 A-Scan. An A-scan presentation is a plot of time versus amplitude and is displayed on an ultrasonic instrument in the form of a horizontal baseline that indicates time or distance. A-scan signals deflect vertically from the baseline to indicate the amplitude of electrical pulses (echoes) received from the transducer. On a calibrated ultrasonic instrument, flaw depth can be determined from the horizontal position of the echo on the baseline. The upper half of [Figure 5-45](#) represents an A-scan display corresponding to the contact inspection shown in the lower half of the figure. A-scan presentations are the most utilized ultrasonic data presentation method and are also referred to as distance-amplitude presentations.

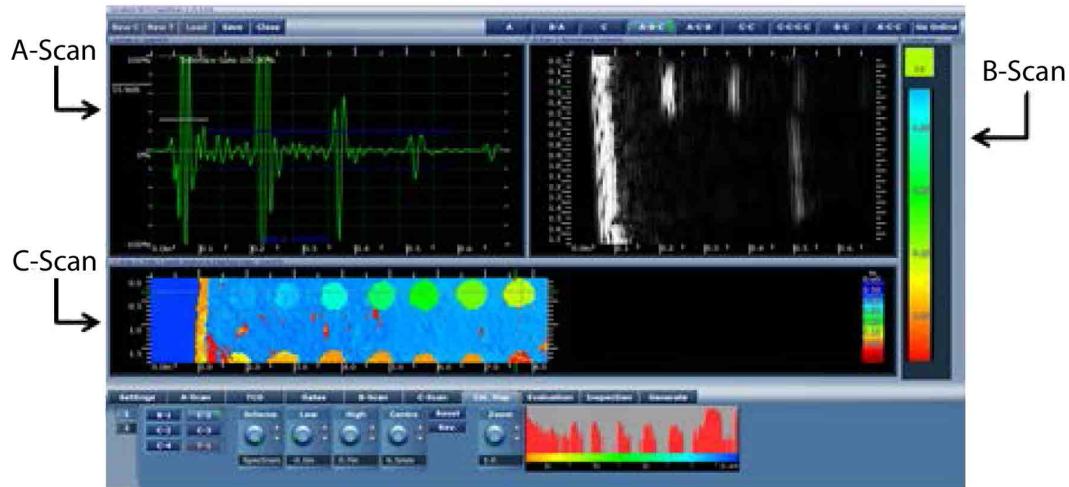


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Figure 5-45. Typical A-Scan Display for Contact Inspection

5.4.4.2 **B-Scan.** A B-scan presentation provides a cross-sectional view of the test piece. This requires a device encoder that plots the time of arrival of the pulse, as a function of the physical location of the transducer. B-scans are typically generated by scanning the transducer at a uniform rate, in a straight line across the surface of the test piece. B-scans may be displayed in real-time on the ultrasonic instrument, an external monitor, or an x-y plotter.

5.4.4.3 **C-Scan.** A C-scan presentation provides a plan view of the material and discontinuities therein. This is accomplished by collecting an electronically gated output of an A-scan presentation. The C-scan is generated as the part is scanned in a raster pattern with a manual or automated two-axis scanner. Discontinuities are indicated at positions corresponding to the actual x-y locations of the discontinuities in the part (Figure 5-46). Device encoders to track and relay transducer position to the recorder or display are required. Typically, video displays are produced after the analog signal is converted to digital data. The display can be adjusted so different colors or shades of gray represent different depths or thickness. Signal amplitudes can also be displayed in various colors schemes. Numerous image processing tools may be available to the operator depending on system capabilities.



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Figure 5-46. A-Scan, B-Scan and C-Scan Presentation Examples

5.4.5 Relationship of a Scan Waveform Display to Distance. In a test part containing a discontinuity, ultrasonic energy is reflected as echoes from the discontinuity and the back surface of the test part. Referring back to Data Presentation Method, there are three methods of data presentation used for ultrasonic inspection: A-scan, B-scan, and C-scan. Notice the positions of the displayed signals on the display screen in relation to the actual positions of the test-part front surface, discontinuity, and back surface. The distance along the display screen baseline is proportional to the distance to the discontinuity and back surface in the test part. The signals on the display screen were adjusted to position the initial pulse on the grid marked “0” and the back surface signal on the grid marked “4.” The discontinuity then appeared just to the right of the grid marked “1.” The adjustments of the signals on the display screen were accomplished by varying two controls on the instrument, the Sweep Delay and the Sweep Length or Range. The adjustment made each space between the vertical grid lines on the display screen equivalent to 1 inch in the test part.

5.4.6 Common Inspection Techniques.

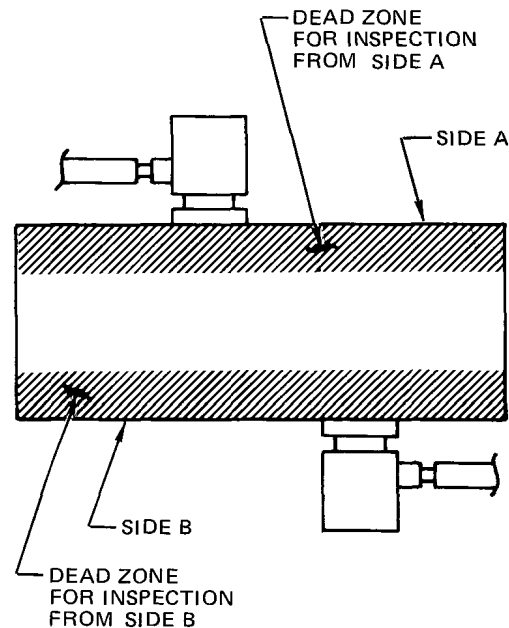
5.4.6.1 Straight Beam (Longitudinal) Pulse-Echo Technique.

5.4.6.1.1 General. This technique uses longitudinal waves ([Paragraph 5.2.3.1](#)).

5.4.6.1.2 Limitations.

5.4.6.1.2.1 Dead Zone. The dead zone ([Paragraph 5.2.6.1](#)) interferes with contact inspection ([Paragraph 5.4.2.1.1.1](#)) of near-surface regions of parts. When required, the coverage of a straight beam inspection in near-surface regions can be extended by several different techniques, such as the following:

- Inspect the part from opposite sides. The dead zone, which is not inspected from the first side, is covered when inspecting from the second side ([Figure 5-47](#)).
- Use a dual-element transducer ([Paragraph 5.3.2.6](#)).
- Use a delay line contact transducer ([Paragraph 5.3.2.8](#)).
- Use an immersion inspection method.



THE DEAD ZONE OF THE SIDE A INSPECTION IS COVERED BY THE SIDE B INSPECTION; THE DEAD ZONE OF THE SIDE B INSPECTION IS COVERED BY THE SIDE A INSPECTION.

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Figure 5-47. Inspection of Test Part Opposite Sides to Provide Coverage of Dead Zone Areas

5.4.6.1.2.2 High Attenuation. In some cases, when inspecting thick sections, the sound energy in the part drops below usable levels. If this happens, inspecting from opposite sides can help, since only half the section thickness needs to be covered in a single inspection. If inspecting from two sides, the zones must overlap by a minimum of 1/2-inch. The through-transmission technique may also help alleviate high attenuation limitations.

5.4.6.2 Straight Beam Multi-Transducer Technique.

5.4.6.2.1 Through-Transmission Technique. Through-transmission also uses the straight beam ([Paragraph 5.3.2.3.1](#)) method, but this method requires two transducers, one to transmit the signal and one to receive the signal. In through-transmission inspection, a transmitting transducer is placed on one surface and the receiving transducer is placed on the opposite surface of the test piece. In this technique, discontinuities (voids) block the passage of sound resulting in a reduction of the received signal ([Figure 5-48](#)). Since the echoes from the discontinuities are not received, the depth of information cannot be determined.

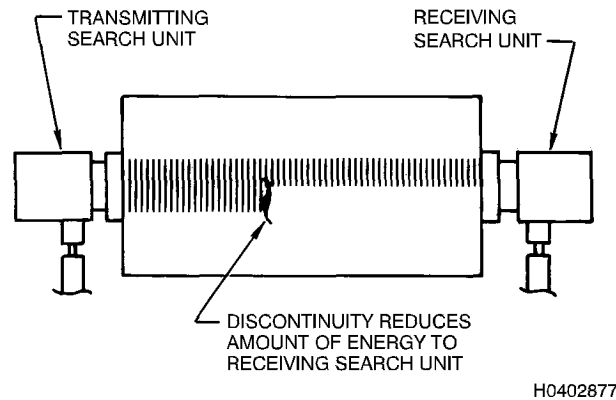


Figure 5-48. Through-Transmission Inspection

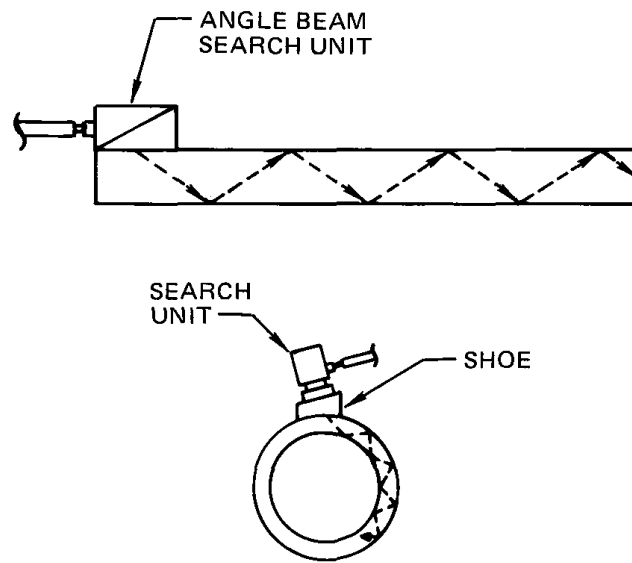
5.4.6.2.1.1 **Beam Alignment.** A major problem encountered with through-transmission testing is maintaining alignment of the transducers. Misalignment can reduce the amplitude of the received signal. Anything causing the received energy to suddenly drop can be misinterpreted as a defect. The through-transmission technique is useful when insufficient energy is obtained with the pulse-echo method and can be applied to inspect thick materials (distances up to 80-feet have been inspected). The through-transmission technique can also be used to advantage on thin test parts when the dead zone prevents an inspection with the pulse-echo method.

5.4.6.2.2 **Application of Through-Transmission.** The straight beam ([Paragraph 5.3.2.3.1](#)) technique is used to detect discontinuities with at least one surface oriented parallel to the test surface. Typical discontinuity examples are laminations, corrosion, high-and low-density inclusions, porosity, forging bursts, and cracks. Applications of the straight beam technique depend upon the test part geometry.

5.4.6.3 **Angle Beam (Shear Wave) Technique.**

5.4.6.3.1 **General.** This method generally uses shear waves ([Paragraph 5.2.3.2](#)) refracted in the test part at angles of 30° to 70°.

5.4.6.3.2 **Angle Beam Applications.** The angle beam technique is used extensively in field nondestructive inspections and can provide for inspection of areas with complex geometries or limited access. This is because angle beams can travel through a material by bouncing from surface to surface. Useful inspection information can be obtained at great distances from the transducer. Angle beam inspections are particularly applicable to inspections around fastener holes, inspection of cylindrical components, examination of skins for cracks, and inspection of welds; [Figure 5-49](#) shows typical angle beam inspections.



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Figure 5-49. Angle Beam Inspection

5.4.6.3.3 Multiple Search Units (Angle Beam). Most angle beam methods use a single transducer with one transducer element for transmitting and receiving ultrasonic energy. Special applications MAY utilize dual angle-beam transducers ([Figure 5-28](#)) or two or more angle beam units, one for transmitting, the rest for receiving, but due to beam alignment issues, this technique generally requires special fixtures to ensure correct transducer spacing and alignment.

5.4.6.4 Surface Wave (Rayleigh) Technique.

NOTE

When surface waves are used to inspect painted surfaces, the technician SHOULD be aware during setup and interpretation, the possibility of surface reflection from scratches and breaks in the painted surface. Rough surfaces or liquid on the surface can also attenuate surface waves. When sliding a transducer toward and then away from the suspect area, a ridge of couplant is often created that can reflect part of the surface wave energy and be mistaken for a crack. The area in front of the transducer SHALL be kept free of all, but the minimum amount of couplant needed for the inspection.

5.4.6.4.1 General. This technique uses surface (Rayleigh) waves ([Paragraph 5.2.3.3](#)) refracted in the test part at an angle of 90°. These waves propagate such that they must be bounded by air along the surface of the test specimen so this technique will work only during contact inspections ([Paragraph 5.4.2.1.1.1](#)).

5.4.6.4.2 Surface Wave Applications. Surface wave ([Figure 5-50](#)) inspections can be utilized in many field NDI applications involving surface cracks or slightly subsurface discontinuities. On smooth surfaces, sound energy can travel long distances with little energy loss. Surface waves travel around curved surfaces. They reflect at sharp edges (radius less than one wavelength). Complete reflection does not occur even at sharp edges.

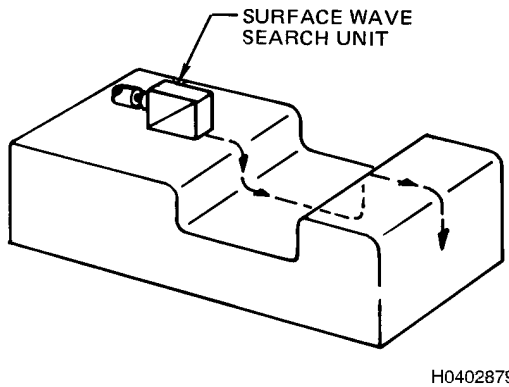


Figure 5-50. Surface Wave Inspection

5.4.6.4.3 Surface Wave Familiarization.

- a. Use a miniature angle-beam block. Attach a 2.25 MHz surface wave transducer to the ultrasonic instrument.
- b. Position the transducer at P-1 as shown in [Figure 5-51](#). Adjust the sweep and gain to obtain a signal from corner C.

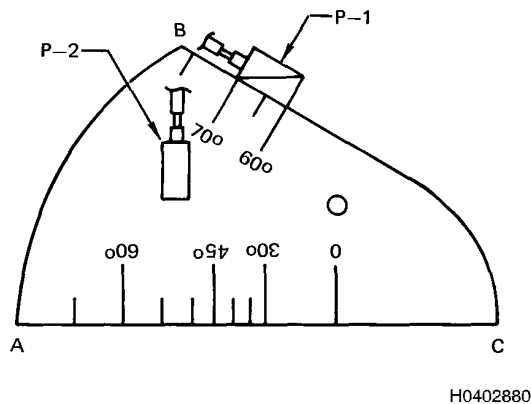


Figure 5-51. Surface Wave Familiarization

- c. Moisten a finger with couplant and move it across the surface from the transducer toward corner C.

NOTE

The corner signal is damped until the finger moves beyond the corner.

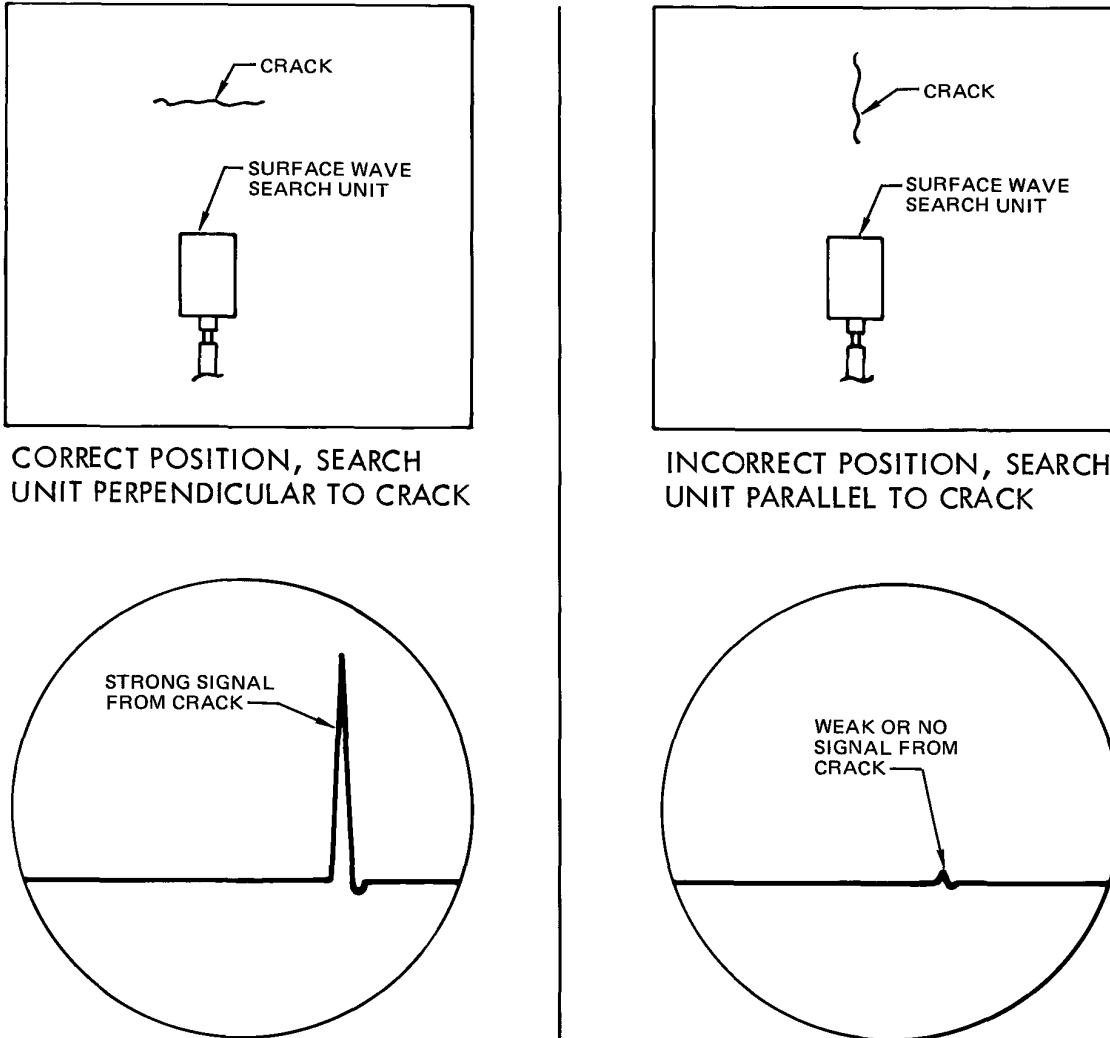
- d. Move the transducer away from corner C toward corner B as shown in [Figure 5-51](#).

NOTE

The corner C signal moves to the right along the time base.

- e. Position the transducer at P-2 as shown in [Figure 5-51](#). Orient the transducer perpendicular to edge AC. Adjust the sweep and gain to obtain a signal from edge AC.

- f. Rotate the transducer and note the signal from the edge decreases as the transducer is rotated away from the normal to the edge. This illustrates surface waves SHOULD always be directed perpendicular to the expected plane of cracks ([Figure 5-52](#)).



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Figure 5-52. Correct and Incorrect Transducer Orientation for Finding Cracks With Surface Waves

5.4.6.5 Lamb (Plate) Wave Technique. If the thickness of a test part is less than one wavelength of the sound introduced at the appropriate incident angle, lamb waves ([Paragraph 5.2.3.4](#)) travel between the two parallel surfaces of the part. This is a special technique not widely used.

5.4.7 Ultrasonic Technique Development. As with the other NDI disciplines, most ultrasonic techniques used in the field are established at the depot. In certain situations, it MAY be necessary to develop a technique in the field. If such a need arises, the following information will aid in developing the required techniques. The information may also lead to a better understanding of established techniques.

5.4.7.1 **Information Required.** When establishing an ultrasonic inspection technique, it is first necessary to obtain as much information as possible about the test part. Information required is as follows:

- Type of material to be inspected, and heat treatment
- Surface condition
- Accessibility
- Shape/geometry of test part
- Type of discontinuity to look for
- Expected location and orientation of discontinuity
- Expected orientation of discontinuity with respect to sound path
- Size defect that must be reliably detected (acceptance/rejection criteria)
- Inspection technique required
- Inspection zones, if applicable

5.4.7.1.1 Information on many of the above items can be obtained by visual examination of the test part and study of applicable manuals and drawings. Examination of failed parts is helpful for obtaining information on the location of and type of discontinuity causing failure.

5.4.7.2 **Defining the Technique.** The information required by [Paragraph 5.4.7.1](#), along with the information in this chapter, is used to establish the technique variables. In addition, if welds are to be inspected (TO 00-25-224). Items that need to be defined are listed below and described in more detail in the subsequent paragraphs.

- Inspection surfaces.
- Mode(s) of inspection: longitudinal, shear and/or surface wave, contact, or immersion.
- Scanning plan.
- Reference standard(s).
- Transfer method.
- Frequency.
- Transducer.
- Requirements for special wedges or shoes.
- Surface preparation required and method to be used.
- Type of couplant used.

5.4.7.2.1 **Inspection Surfaces, Scan Plan, and Mode(s).** The expected location and orientation of discontinuities, along with accessibility of the inspection area, are used to help define which surfaces will be used for sound entry, the mode(s) of sound energy used, and the scanning procedure. The sound SHOULD be directed normal to the expected plane of the largest surface of the discontinuity. Therefore, straight beam ([Paragraph 5.3.2.3.1](#)) inspection would be used to locate laminar discontinuities, and angle beam inspection would be used to locate internal discontinuities not parallel to the inspection sur-

face. For many angle beam inspections, the sound is directed so it bounces back from a corner formed by a crack and the far surface or a fastener hole. When discontinuities are expected on the inspection surface, a surface wave inspection may be a better choice.

5.4.7.2.2 Reference Standard. The reference standard SHOULD be fabricated from material with the same acoustic properties as the test part. When possible, the reference standard SHOULD be of the same alloy, heat treat condition, same hot/cold work condition, and the same surface condition as the test part. When the material condition of the standard cannot exactly match the part, a transfer technique ([Paragraph 5.4.9](#)) may be needed to compensate for the differences. The geometry of the reference standard SHOULD match the geometry of the test part so the sound path will be the same. The simulated discontinuities SHOULD be in accordance with the applicable specification for the test part. Refer to SAE-AMS-STD-2154 or ASTM E2375 for general information.

5.4.7.2.3 Frequency Selection. The frequency is selected based upon the acceptance criteria, and the acoustic properties of the test part. A good rule to remember is, “Use the highest frequency that will provide the necessary depth of penetration.” When geometry permits, the test part SHALL be checked at the intended frequency to verify a strong back reflection is obtained. The frequency SHOULD also be appropriate for detecting the minimum size discontinuity anywhere in the test part. Frequencies in the range of 2.25 MHz, 5 MHz and 10 MHz are popular for inspections. When using both the angle beam method (either refracted shear or longitudinal wave) ([Paragraph 5.3.2.3.2](#)) and the straight beam method (longitudinal wave) ([Paragraph 5.3.2.3.1](#)), the frequency used for the angle beam shear wave inspection SHOULD be about one-half the frequency used for the straight beam inspection. This provides approximately the same wavelength for both the longitudinal and shear waves ([Paragraph 5.2.3.2](#)). Refracted longitudinal wave inspection SHOULD be at the same frequency used for straight longitudinal wave ([Paragraph 5.2.3.1](#)) inspection.

5.4.7.2.4 Transducer Selection. The transducer is selected based on the requirements for mode, frequency, beam direction, and beam size. The part geometry and the limitations on accessibility to the inspection surface determine if special wedges or shoes are required. Refer to [Paragraph 5.3.4](#) for information on wedges and shoes.

5.4.7.2.5 Surface Preparation. The sound entry surface is visually examined to determine if any special preparation is required to provide a suitable condition for ultrasonic inspection. The surface finish SHOULD be 250-microinches or smoother. Painted surfaces can normally be inspected without removing the paint, if the paint is uniform and is tightly adhered to the part surface. Loose or uneven, patchy paint SHALL be stripped prior to ultrasonic inspection.

5.4.7.2.6 Couplant Selection. The couplant is selected based upon the surface condition, the surface orientation, and the information in [Paragraph 5.3.5](#).

5.4.8 Distance Amplitude Correction (DAC) Curve.

5.4.8.1 General. Distance Amplitude Correction (DAC) is not a process control, but is used when it is necessary to compensate for sound attenuation with increasing metal travel distance. Many instruments have built-in DAC features, in these cases; follow the instructions in the operator’s manual for establishing a DAC curve.

- a. A typical DAC curve is shown in [Figure 5-53](#).
- b. A DAC curve is usually not necessary for surface wave inspections, because the transducer can generally be moved back and forth from a discontinuity to maximize the signal. If a DAC curve is needed for a surface wave inspection, it can be easily established. The transducer is placed at a few points at different distances from the reference standard reflector. At each point, the peak amplitude is measured and marked on the display. A smooth curve is then drawn through the points as in the straight beam ([Paragraph 5.3.2.3.1](#)) and angle beam ([Paragraph 5.3.2.3.2](#)) procedures.

5.4.9 Attenuation Correction (Transfer).

5.4.9.1 Description. Transfer (attenuation correction) refers to methods used to compensate for differences in ultrasonic transmission characteristics between the test part and the reference standard. For example, the surface condition of the reference standard, test part, and the internal structures (e.g., grain size, heat treat condition, etc.) could differ. Such differences may cause the signal from a discontinuity in the test part to differ from the signal from the same size discontinuity in the reference standard. In order to obtain consistent results from ultrasonic inspections, it is necessary to use transfer to correct for these differences.

5.4.9.2 General Procedure.

- a. Transfer SHALL be accomplished by making note of the dB or gain difference in the responses received from reflectors in the reference standard and the part or piece of material to be inspected.
- b. Use the echo signals from the same type of reflector in both the reference standard and the test part to establish transfer. For example, use back surfaces, flat-bottom holes, side-drilled holes or “V-notches” (for angle beam inspections). If possible, a minimum of four reflections from different locations in the part or piece of material to be tested SHALL be noted, and the lowest response SHALL be used for comparison with the response from the reference standard. In practically all cases, any alteration of the test part is prohibited. Therefore, transfer SHALL be accomplished using reflectors already included in the test part. Typical reflectors are the back surface or a fastener hole.

5.4.9.3 Examples of Transfer.

5.4.9.3.1 Straight Beam Inspection of a Two Inch Plate.

NOTE

Newer UT machines with Time Controlled Gain (TCG) eliminate the need for manual transfer.

- a. Suppose a specification requires any material with a discontinuity signal greater than the signal from a 5/64-inch diameter FBH is unacceptable. The inspection is set up by establishing a DAC curve in accordance with [Paragraph 5.4.8.1](#). Use ASTM blocks with 5/64-inch diameter FBH's and metal travel distances of 1/8, 1/4, 1/2, 3/4, 1-1/2, and 3-inches.

NOTE

Since the dead zone extends beyond 1/8-inch, the 1/8-inch point is not shown. Also notice, the near field appears to end around 3/4-inch.

- b. After constructing the DAC curve, the amount of transfer is established through use of back surface reflections. The transducer is placed on the 1 1/2-inch metal travel ASTM standard as shown in [Figure 5-53](#). This gives 2 1/4-inch metal travel to the back surface. The gain control is set to bring the back surface signal to the DAC curve as shown in [Figure 5-54](#). This gain setting is maintained, and the transducer is placed on the test part. Assume the first signal shown is obtained. This is 50-percent lower or 6 dB lower than the DAC curve at the 2-inch metal travel distance. This is the amount of transfer; the amount by which the gain must be increased after calibration.

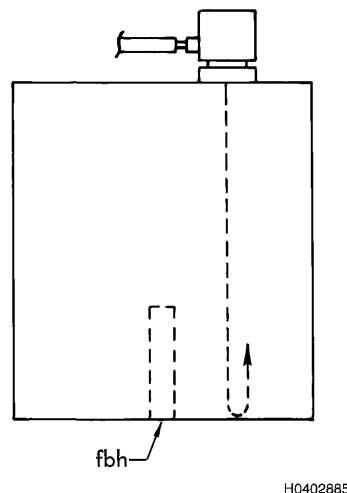
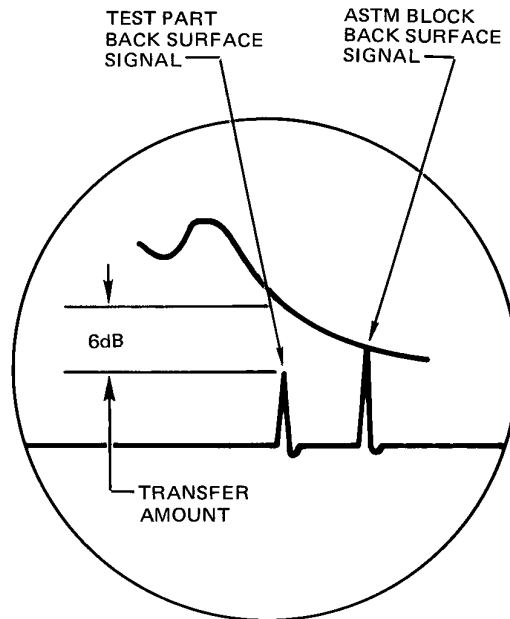


Figure 5-53. Transducer on ASTM Block for Determining Transfer Amount



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Figure 5-54. ASTM Block and Test Part Back Surface Signals

- c. The transducer is now placed on the ASTM block with 1 1/2-inch metal travel distance to the FBH. The signal from the FBH is maximized, and the gain is adjusted to bring the signal to the DAC curve level. Transfer is now applied by increasing the gain setting to double the amplitude. On an instrument with dB gain controls, this is easily accomplished by adding 6 dB to the gain or subtracting 6 dB of attenuation. On an instrument without dB controls, the gain must be increased to double the amplitude of a signal on the display. A correct way of doing this is as follows:
- (1) Place the transducer on the 3-inch travel distance block and adjust the position for maximum signal from the FBH. Note the amplitude of the signal. (It SHOULD be close to 30-percent of full screen height.)
 - (2) Increase the gain until the amplitude of the signal is doubled (e.g., 30-percent to 60-percent). The gain is now set for evaluation of discontinuities in the test part. Any discontinuity signal that exceeds the DAC curve is cause for rejection.

NOTE

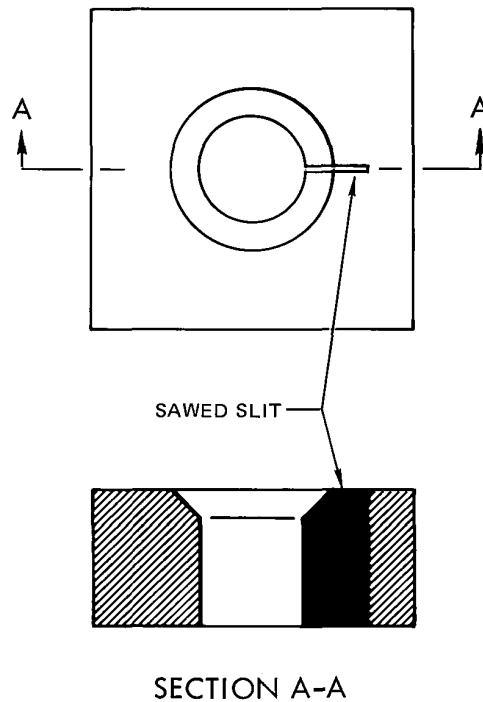
Doubling the gain by doubling the signal (e.g., 50-percent saturation to 100-percent saturation) from the flat bottom hole in the 1 1/2-inch metal travel distance ASTM block would be improper; the 100-percent of saturation signal is in a possible nonlinear area of the display. Signals at levels above 90-percent of saturation SHALL NOT be used for applying transfer.

- d. The gain setting obtained after applying transfer is used for evaluation of discontinuities in the test part. It is advisable to perform the initial inspection using an even higher gain setting. This provides for more reliable detection of discontinuities. When discontinuities are found, the gain is reduced to the level established by the transfer technique. At this gain setting, any discontinuity signal that exceeds the DAC curve is cause for rejection.

NOTE

In the above example, the metal travel distances to the back surface of the reference standard and the test part were not equal. By using the DAC curve in establishing the transfer, this difference was corrected.

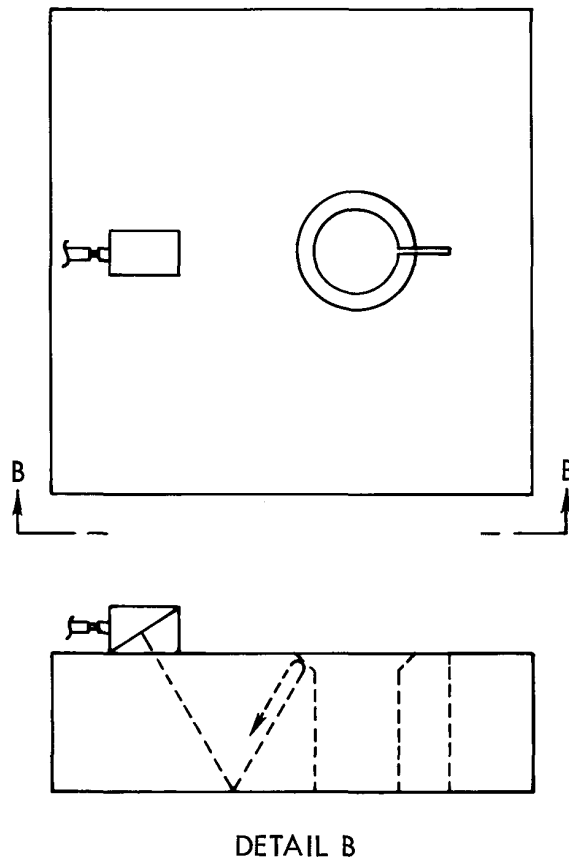
5.4.9.3.2 **Transfer of Angle Beam Inspection for a Skin Crack.** Use a reference standard configuration as shown in [Figure 5-55](#). The reference standard SHOULD be same thickness and material as skin to be examined. Specify the size of the saw cut; the inspection is set up using the saw cut to establish the sensitivity. Any discontinuity having a signal exceeding 25-percent of the saw cut signal is cause for rejection. Transfer is established as follows:



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Figure 5-55. Reference Standard for Inspection for Cracks in Skin

- a. Place the transducer on the reference standard, as shown in [Figure 5-56](#), and position it to obtain a maximum signal from the top corner of the wall of the fastener hole. Adjust the gain to bring the signal to 50-percent of saturation.



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Figure 5-56. Positioning Transducer for Establishing Transfer

- b. Place the transducer on the skin, and maximize the signal from the same size fastener hole as in the standard by adjusting the position of the transducer. The gain setting used for the fastener hole in the standard SHALL NOT be changed.
- c. Suppose the signal obtained from the fastener hole in the skin is 80-percent of saturation. This is an increase of 60-percent (4 dB) of the signal from the reference standard fastener hole (30 = 60-percent of 50). This is the amount of transfer, the amount by which the rejection (alarm) level has to be raised.
- d. Place the transducer back on the reference standard to obtain the signal from the saw cut. Increase the gain until the signal is at some convenient level, for example, 80-percent of saturation. At this gain 20-percent of full scale would be the rejection level, since any signal exceeding 25-percent of the saw cut signal is cause for rejection; however, this rejection level must be increased to 32-percent of full scale by the amount of transfer (60-percent or 4 dB). Therefore, any discontinuity that exceeds 32-percent of saturation is cause for rejection. As in the previous example, the initial scanning is performed at a higher gain setting.

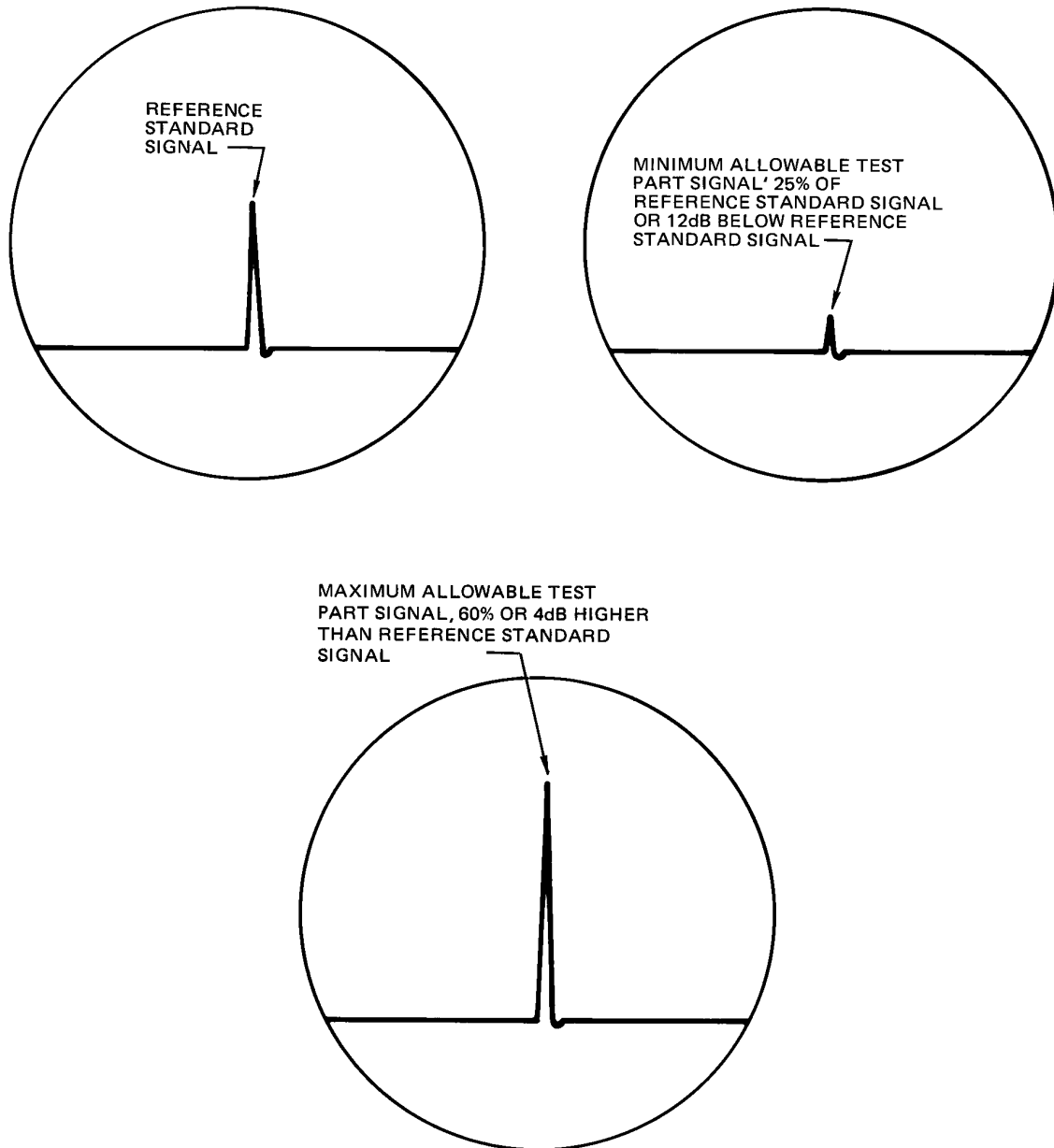
5.4.9.3.3 Straight Beam Technique of Transfer Applied to Angle Beam Inspection. The straight beam inspection ([Paragraph 5.3.2.3.1](#)) technique of transfer ([Paragraph 5.4.9.3.1](#)) may also be applied to angle beam inspections. A straight beam transducer is used to determine the amount of transfer. This amount of transfer is then applied to the angle beam inspection. When using this technique, the following conditions SHALL be met.

5.4.9.3.3.1 The frequency of the straight beam transducer SHALL be approximately double the frequency of the angle beam transducer. For a 2.25 MHz angle beam transducer, use a 5 MHz straight beam transducer. For a 5 MHz angle beam transducer, use a 10 MHz straight beam transducer.

5.4.9.3.3.2 The back surface of the standard and the test part must be located in the far field of the straight beam transducer.

5.4.9.3.3.3 The back surfaces of the reference standard and the test part must be parallel with the front surfaces.

5.4.9.4 Transfer Limits. When using the transfer technique, if the signal from the test part is less than 25-percent (-12 dB) or more than 60-percent (+4 dB) of the signal from the reference standard ([Figure 5-57](#)), the reference standard may be of the wrong material, heat treat condition and/or surface condition. If the signal from the test part is not within the above limits, another reference standard SHOULD be tried, or the prime depot SHOULD be contacted.



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Figure 5-57. Transfer Limits

5.4.10 Inspection of Bonded Structures.

5.4.10.1 Definition. A bonded structure is one consisting of two or more components adhesively bonded together. The structure can be all metallic or nonmetallic, or it can consist of both types of material. A bonded structure can contain honeycomb or other type of light-weight core. Sheets of metal or nonmetal can be bonded together to provide the appropriate thickness. Carbon/epoxy composites are bonded structures although the individual layers are only a few thousands of an inch thick, and essentially lose their individual identity in the curing process; however, separations (delaminations) do occur between layers as a result of external impacts with foreign objects.

5.4.10.2 Variables Applicable to Bonded Structures. There are many configurations and types of bonded structures, thus, there are many variables to consider when performing NDI.

- Probe-side skin material and thickness.
- Adhesive type and thickness.
- Underlying structure - core material, thickness of core, cell size, and thickness of cell wall, far-side skin material and thickness, quantity, thickness and material of doublers, attachments of closure members, foam adhesive, steps in skins, internal ribs, and makeup of nonmetallic composite laminates (material, number of layers and layer thickness).
- Accessibility - one skin or both skins.

5.4.10.2.1 All of these variations complicate the application of ultrasonic inspection methods. A method, which works well on one part or in one area of the part, MAY NOT be applicable for different parts or different areas of the same part.

5.4.10.3 Special Requirements. Because of the many inspection configurations, each application must be examined in detail. The advantages and limitations of each inspection method must be considered, and reference standards (representative of the structure to be inspected) SHALL be ultrasonically inspected to verify proposed techniques. Scanning speeds must be identical on both the standard and the test part. Scan line indexing must be no larger than one-half the width of the smallest rejectable discontinuity.

5.4.10.3.1 The internal configuration of the bonded test part must be understood by the operator. Drawings SHOULD be reviewed and, when necessary, radiographs taken to provide a better understanding of the area under investigation. Knowledge of details such as the location and boundaries of doublers, ribs, etc. is required for valid interpretation of ultrasonic inspection results. The boundaries of internal details SHOULD be marked on the test part using an approved marking method.

NOTE

Grease pencils, chalk, or other marking device may harm the material under evaluation (e.g., lead pencil could lead to burn through). The weapons system technical manual SHALL be consulted for guidance on marking methods.

5.4.10.3.2 This section does not include all the information required to establish techniques. Detailed techniques for specific structures SHOULD be obtained from the applicable NDI manual, or from written authority provided by the prime depot level engineering activity. In addition, further information on the operation of specific instruments SHOULD be obtained from the applicable equipment manuals.

5.4.11 Thickness Measurement.

NOTE

State-of-the-art instruments provide highly accurate thickness measurements from 0.005-inch up to several feet. These instruments not only measure thicknesses in inches and millimeters, but can also determine the velocity of the material under test.

5.4.11.1 Thickness Measurement Applications. Examples of applications for ultrasonic thickness measurement are as follows:

- Checking part thickness when access to the backside is not available.

- Checking large panels in interior areas where a conventional micrometer cannot reach.
- Maintenance inspections for checking thickness loss due to wear and/or corrosion.

5.4.11.2 General Principles. Two basic methods of measuring thickness ultrasonically are the pulse-echo method and the resonance method.

5.4.11.2.1 Thickness Measurement With the Pulse-Echo Method. The pulse-echo method is now the most commonly used ultrasonic thickness measurement method. This method uses the basic principle defined by the following equation:

$$d = vt$$

Where:

d = distance (inches)

v = velocity (inches per second)

t = time (seconds)

5.4.11.2.1.1 The ultrasonic instrument is capable of measuring time between the initial front and back surface signals or between successive multiple back reflection signals. Since the velocity for a given material is a constant, the time between these signals is directly proportional to the distance (thickness). Calibration procedures are used to obtain a direct readout of test part thickness. The accuracy depends on the surface condition, the transducer, and the instrument. On smooth surfaces (63-microinches or less), accuracy of ± 0.001 -inch, or better, can be obtained on the lower ranges of some digital-readout instruments. Readout resolution is usually 0.001 inch. On other ranges, ± 0.5 -percent of full scale is a typical accuracy.

5.4.11.2.2 Resonance Technique. Resonance equipment has been largely replaced by pulse-echo equipment for thickness measurement. This technique uses an instrument which applies continuous (as opposed to pulsed) electrical energy to the transducer. The frequency of this energy is continuously changing; therefore, the wavelength of the sound transmitted by the transducer is continuously changing too, but it is changing inversely in proportion to the velocity of the material being tested ($\lambda = v/f$). When the transducer is coupled to a test part, and when one of the transmitted wavelengths is a multiple of the thickness of the part, the piezoelectric element in the transducer vibrates with higher amplitude. When this occurs, the transducer is said to be in resonance with the part. If the instrument is calibrated on a reference standard so that the peaks in the transducer element vibration amplitude correspond to known reference thicknesses, the instrument will indicate unknown thickness of a test part.

5.4.11.3 Thickness Measurement Correlation Factor. As discussed earlier, reference standards are required to calibrate the instruments prior to thickness inspection. If reference standards of a different material or heat treat condition are used, the resultant thickness readings SHALL be corrected by a correlation factor. The correlation factor is located in [Paragraph 5.7.8](#).

5.4.11.3.1 Flat surfaced reference standards MAY be used for measurements on convex radii of curvature as small as 1-inch and concave radii of curvature as small as 3-inches. Test parts with radii smaller than 1-inch convex or 3-inches concave, require reference standards with curved surfaces and radii equal to the test part radii, ± 10 -percent. In addition, shoes are required ([Paragraph 5.3.4.1](#) and [Paragraph 5.3.4.2](#)).

5.4.11.3.2 The surface finish of reference standards SHOULD be 63-microinches or better if maximum accuracy is to be obtained. Surface roughness introduces errors as shown in [Table 5-7](#).

5.4.11.3.3 The thickness of reference standards SHALL be measured by mechanical or optical means. Unless otherwise specified, the maximum tolerance for these measurements SHALL be ± 0.001 inch or $\pm 0.1\%$ of the thickness, whichever is greater.

5.4.11.3.4 If there are two or more areas of different thickness on the test part within the limits of [Paragraph 5.4.11.3.3](#), which can be measured both ultrasonically and mechanically, or optically, these areas MAY be used as the standards.

5.4.12 Calibration and Thickness Measurement. Accurate thickness measurements require the reference standards and the test part, to have equal temperatures, within 10° F. Calibration SHALL be performed in the same physical location as the measurements on the test part. Adequate time SHOULD be allowed for the reference standard to reach the test part temperature. The horizontal linearity of the test equipment is crucial, and must be checked prior to calibration and any thick-

ness measurement. Follow detailed instructions for performing thickness measurement with the specified ultrasonic instrument by consulting the specific instrument manual or TO 33B-1-2.

SECTION V ULTRASONIC INSPECTION INTERPRETATION

5.5 INTRODUCTION.

5.5.1 Evaluation of Discontinuity Indications. When a discontinuity indication is found, it is desirable to learn as much as possible about the discontinuity (or discontinuities). Information on the location, size, orientation, and spacing helps in determining the seriousness of a discontinuity.

5.5.1.1 Discontinuity Location. The location is determined by noticing the position of the indication on the waveform display and comparing this position to the positions of indications from known reflectors, such as the front and back surface. This is simple for straight beam inspections and is explained in [Paragraph 5.4.5](#). For angle beam inspections, the position is determined by first determining the angle of the refracted beam and then performing a distance calibration. With this information, the beam path and distance to the discontinuity in the test part can be determined. It is often helpful to use a cross-sectional sketch of the test part and draw the beam path on the sketch. For surface wave inspections, the location of a discontinuity is easily determined by wetting a finger with couplant, and then moving the finger along the test part surface away from the transducer. The surface waves will be damped by the wet finger, and the discontinuity signal will be reduced in amplitude until the finger moves just past the discontinuity. By noting when the discontinuity signal first starts to increase in amplitude, the location of the discontinuity is determined. A distance calibration can also be easily set up for surface waves. The transducer is placed on the test part at a known distance away from a reflector, such as an edge of the test part, or the transducer can be placed at a known distance from a reflector on the IIW block.

5.5.1.2 Discontinuity Size. The size of a small discontinuity (less than the diameter of the sound beam) is estimated by measuring the maximum signal amplitude produced by the discontinuity. Information on sound beam diameter (beam spread) is contained in [Paragraph 5.2.6.5](#). In general, the amplitude from a small discontinuity is proportional to the cross-sectional area of the discontinuity, if the discontinuity is oriented normal to the sound beam. Since natural discontinuities usually have irregular shapes and rough surfaces, determination of the actual size of small discontinuities in general MAY NOT be possible with ultrasonics. Therefore, estimating the size of small discontinuities by comparing their signal amplitude with the signal amplitude of reference standard discontinuities is subject to errors. When making such comparisons (only to be used for rough estimates), the transfer technique SHOULD be used ([Paragraph 5.4.9](#)). If, after applying transfer, the test part discontinuity signal is as large or larger than the signal from the reference standard discontinuity, it can be concluded the test part discontinuity is at least as large as the reference standard discontinuity. The transfer technique adjusts for differences in material attenuation, not for differences in discontinuity surface irregularities. Estimating the size of discontinuities larger than the sound beam is done by moving the transducer over the discontinuity, and mapping the extremities of the discontinuity. The outer edges of a discontinuity can be estimated by noting the positions of the center of the transducer when the signal amplitude from the discontinuity is reduced to 1/2 its peak value. This procedure estimates the projected area of discontinuities in a plane perpendicular to the incident sound beam.

5.5.1.3 Discontinuity Orientation. In evaluating discontinuities, it is helpful, if possible, to evaluate the discontinuities from several different directions. This can be accomplished by using a combination of angle, and straight beam methods, and/or sound entry from different surfaces. Inspecting in these various directions reveals more about the discontinuity. The direction where the highest amplitude signal is obtained is most nearly perpendicular to the plane of the discontinuity for equivalent distances. If the discontinuity signal changes very little with changing direction, the discontinuity is probably rounded. The sound scattered from a rounded discontinuity is independent of the incident direction. A flat discontinuity gives a maximum reflection when the incident sound beam is perpendicular to the discontinuity.

5.5.1.4 Discontinuity Spacing. Closely spaced small discontinuities can produce multiple indications often accompanied by the loss of back reflection. An example of how large grain size and/or porosity can produce multiple indications and reduce the amplitudes of back-reflection multiples is shown in [Figure 5-58](#). It is necessary to change the A-scan settings to check for both the effects, because the back surface signal probably saturates the display at the gain setting that shows the multiple indications. By lowering the gain and lengthening the sweep range, the decreasing amplitude of multiple back reflections is observed. The rate of decrease in the amplitudes of the back reflection signals will be greater than for an area with no discontinuities.

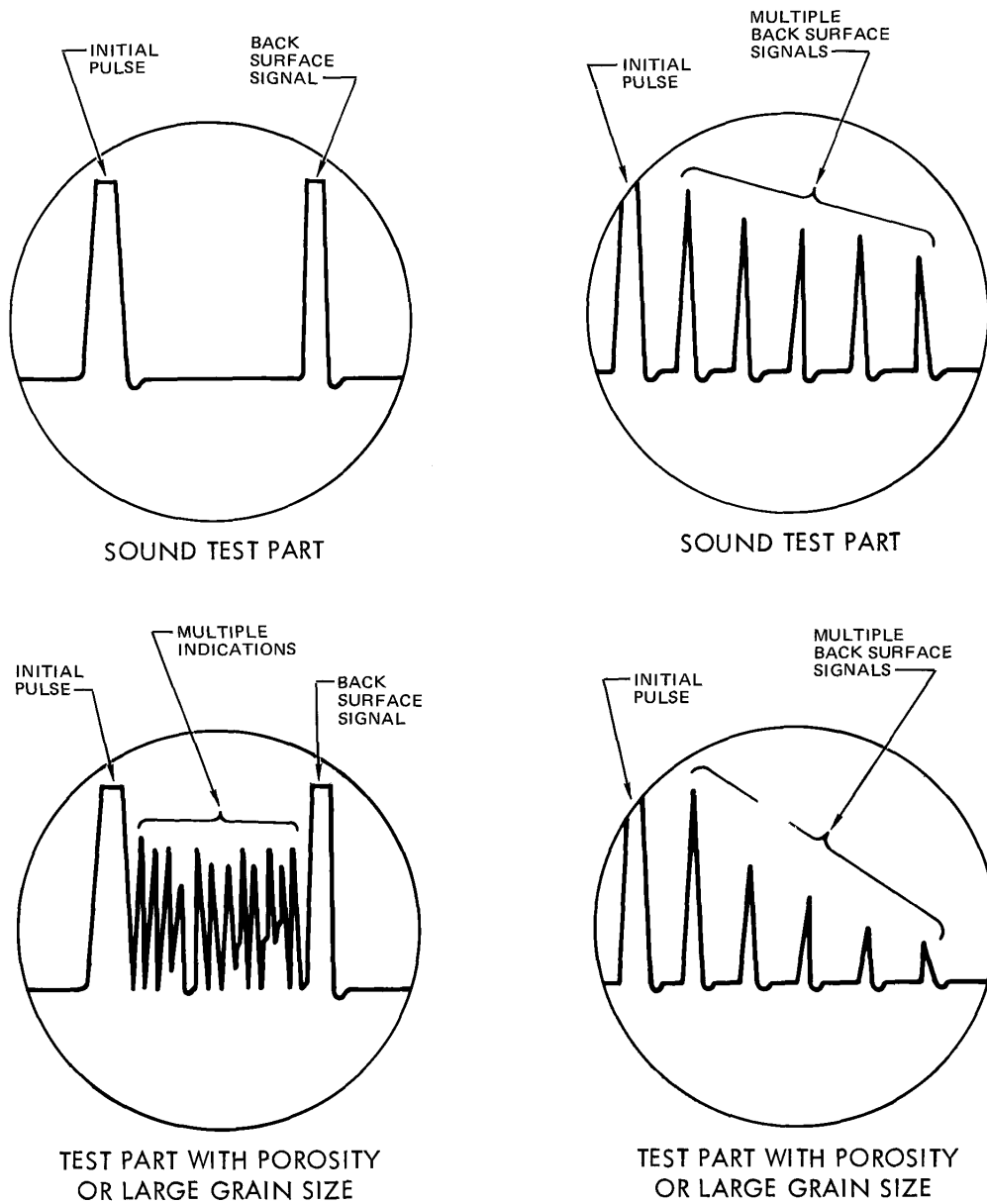
5.5.2 Types of Discontinuity Indications. Several different types of indications will be encountered in ultrasonic inspections. Some of these indications can cause confusion, resulting in false conclusions. It is important for the operator to be

familiar with the ultrasonic system variables ([Paragraph 5.2.5](#) through [Paragraph 5.2.6.7](#)) and the additional information below. This will help the operator in evaluating inspection results and avoiding erroneous conclusions.

5.5.2.1 Loss of Back Reflection and/or Multiple Indications. Loss of back reflection with no other indication can be caused by a number of factors such as the following:

- Large grain size
- Porosity
- Dispersion of precipitated particles in the material
- Overheated structure

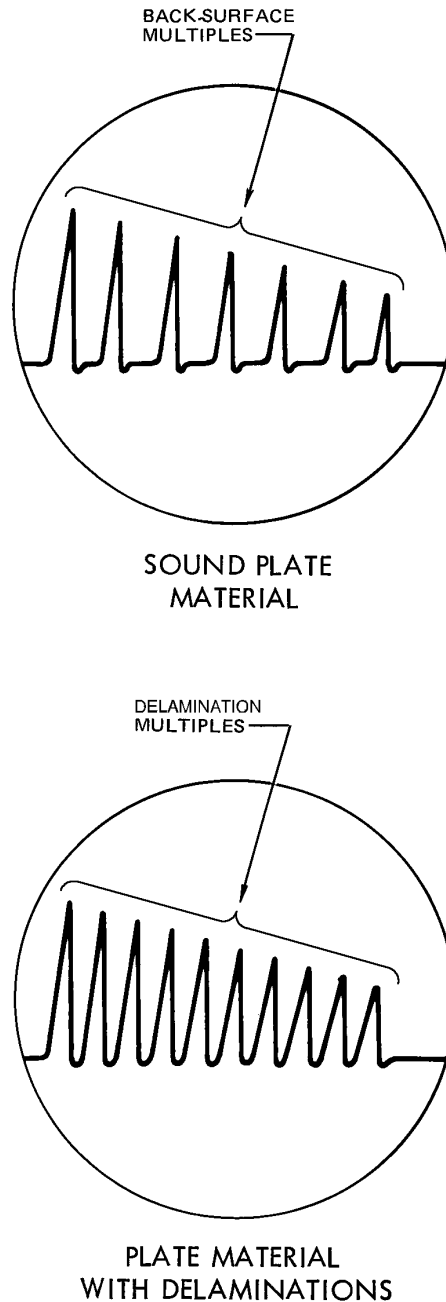
5.5.2.1.1 However, these features could produce multiple indications ([Figure 5-59](#)). Lowering the frequency will generally reduce the multiple indications. When either multiple indications and/or loss of back reflection is noted, the test part SHOULD be compared with the reference standard using transfer in accordance with [Paragraph 5.4.9](#). The results SHOULD be evaluated in accordance with the limits in [Paragraph 5.4.9.4](#).



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Figure 5-58. Example of Multiple Indications and Decrease in Multiple Back Reflections Caused by Large Grain Size or Porosity

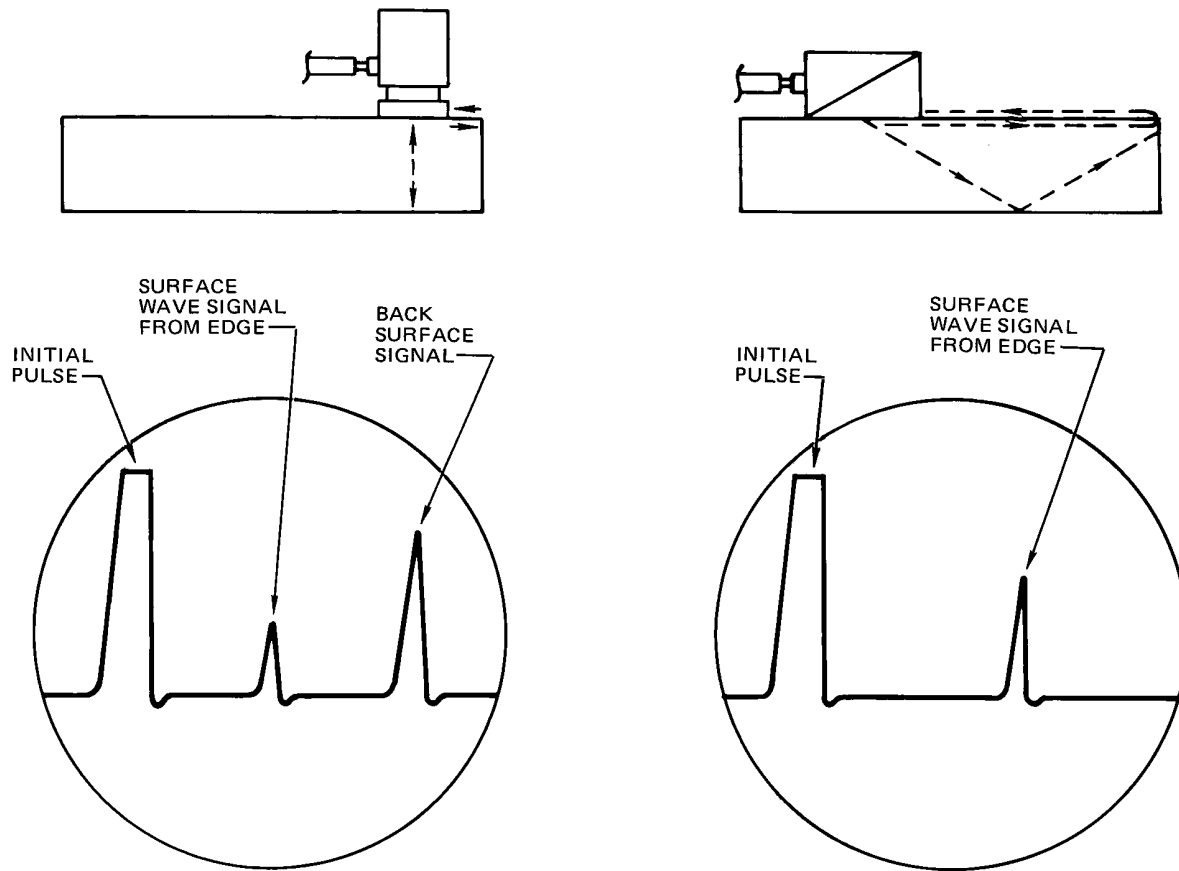
5.5.2.2 Delaminations. When inspecting either metal parts fabricated from sheet, plate, or nonmetallic composite parts, delaminations can be detected by noting what appears to be a reduction in the distance between back reflection multiples as shown in [Figure 5-59](#). Actually, the signals indicate multiple echoes from the delamination instead of the back surface.



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Figure 5-59. Effect of Delaminations in a Plate on Multiple Back Surface Signals

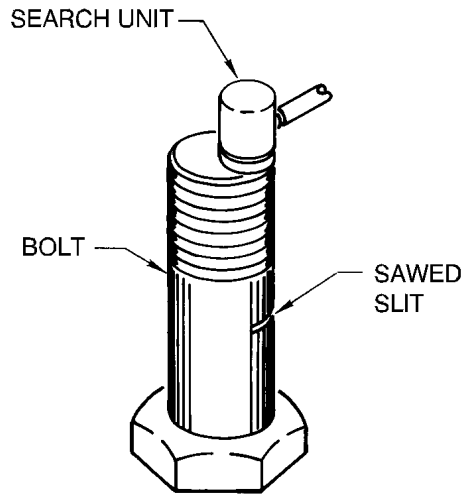
5.5.2.3 Surface Wave Indications in Straight Beam and Angle Beam Inspections. Due to the side lobe energy, surface waves can be generated when using straight beam transducers (Figure 5-12). Surface waves have also been observed in some inspections using angle beam transducer. These surface waves can cause signals from edges of the test part which can be mistaken for a discontinuity. These signals (Figure 5-60) are easily identified by varying the distance between the transducer and the part edge, and watching the signal move. The surface wave signal will move toward the initial pulse as the transducer is moved toward the edge.



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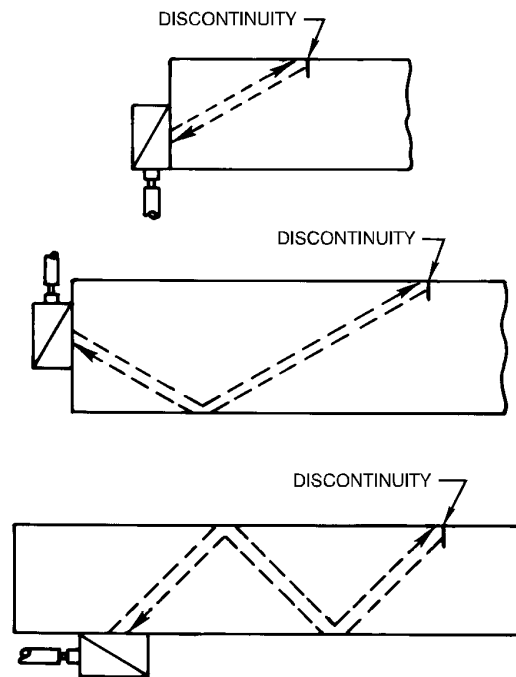
Figure 5-60. Irrelevant Surface Wave Signals

5.5.2.4 Parallel Boundaries. When using straight beam inspection near a boundary parallel to the sound beam axis, the spreading sound beam results in reflections and mode conversion at the boundary ([Figure 5-11](#)). These reflections from the boundary interfere with the main sound beam and can greatly reduce the sensitivity for detecting discontinuities close to or coming from the boundary. Such a case could occur when inspecting a bolt. As the transducer is moved closer to the boundary, the sensitivity is further reduced. When inspecting close to a boundary, it is therefore necessary to use a reference standard with the reference discontinuity located at the boundary. An example of such a discontinuity is a lateral saw cut ([Figure 5-61](#)). Flaws close to boundaries are better located by using, when possible, angle beam techniques ([Figure 5-62](#)).



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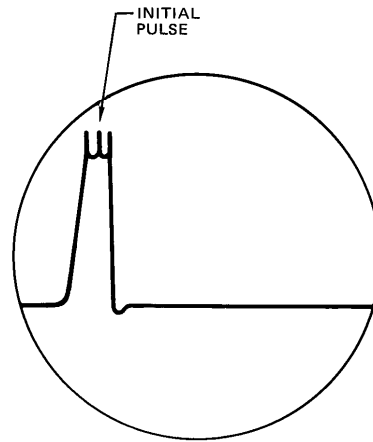
Figure 5-61. Reference Standard for Inspection of a Bolt



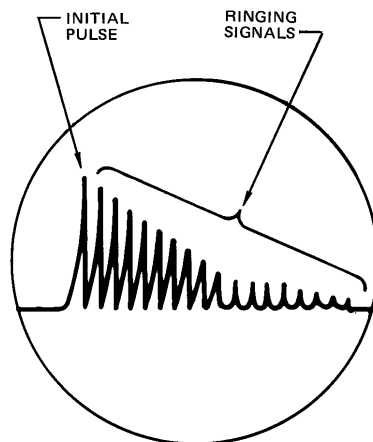
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Figure 5-62. Angle Beam Technique for Locating Discontinuities at Boundaries

5.5.2.5 Loose Transducer Element. A transducer element can separate from the damping material in a transducer. This will cause the initial pulse to become a long ringing signal ([Figure 5-63](#)). Such a situation will cause the search unit to fail the dead zone test. When this happens, the transducer SHALL be replaced.



NORMAL TRANSDUCER ELEMENT



LOOSE TRANSDUCER ELEMENT

H0402895

Figure 5-63. Example of Ringing Signals Due to a Loose Transducer Element

5.5.2.6 External Noise. Noise can be indicated on the waveform display when disturbances are created by such sources as follows:

- Nearby operation of electrical machinery or radio or radar transmitters.
- Machining on the test part (grinding, cutting, filing, etc.) during the inspection.
- Ground loop.

5.5.2.6.1 Noise from the causes listed above are more likely to be encountered when using equipment with a broadband receiver amplifier and/or long cables between the transducer and the instrument. Sometimes a double shield on the cable, as shown in [Figure 5-64](#), will help reduce this noise. In this case, the ground electrode of the transducer element is not connected

to the metal case of the transducer, and the external shield of the connecting cable. The ground electrode is connected to ground via a second internal shield of the cable. Ground is grounded but also for safety reasons. If a ground loop is suspected, tie all grounds together, and connect them to a good earth ground. Portable a/c units can be operated, with constant voltage transformers, and if electrical interference on the a/c circuit is suspected, special transformers are available to block such interference.

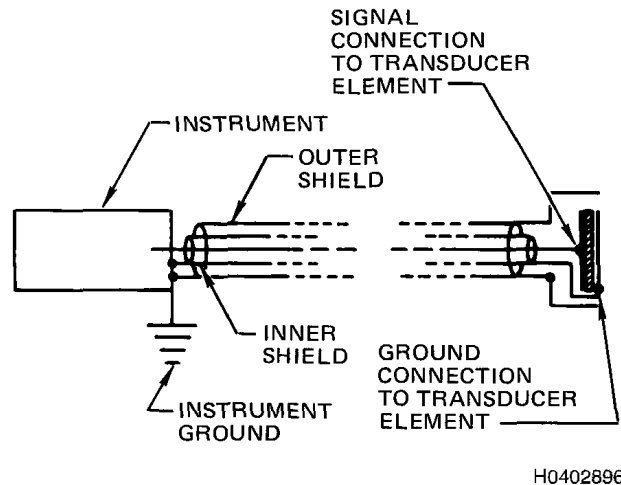


Figure 5-64. Double Shield for Reducing External Noise Signals

5.5.3 Test Part Variables.

5.5.3.1 Surface Condition. Rough surfaces and surfaces with loose or pitted paint, scale, or corrosion, may distort ultrasonic inspection results, preventing a meaningful inspection due to scattering of the sound beam and/or poor coupling. This can cause:

- Insufficient ultrasonic energy reaching discontinuities within the part.
- Loss of resolving power due to an increase in the length of the dead zone caused by a lengthening of the front surface echo. This is caused by reflections of side lobe energy. On smooth surfaces, the side lobe energy is not normally reflected back to the transducer; and therefore, does not interfere with inspection.
- Beam divergence, or widening of the sound beam within the test part.

5.5.3.1.1 To minimize these effects, the sound entry surface and the back surface of a test part SHALL be free from loose, heavy or uneven scale, machining/grinding, or other loose foreign matter.

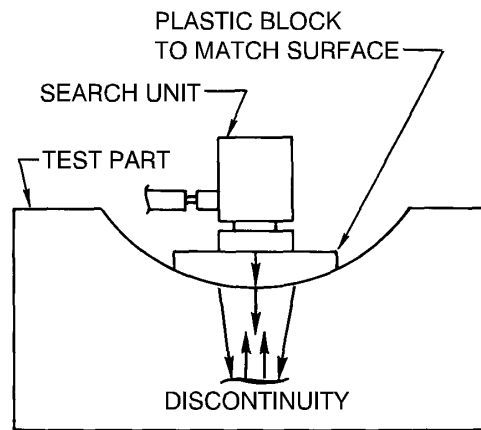
5.5.3.2 Geometry of the Part. The position and shape of the sides and back wall of the part can affect the test. A back surface not parallel to the front surface can result in internal mode conversion and cause confusing indications or complete loss of back reflection. It is important the inspector be familiar with the part geometry prior to inspection.

5.5.3.3 Flat Sound-Entry Surfaces. In the case of test parts with parallel front and back surfaces, it is often required to monitor the back reflection signal in order to evaluate the material and/or assure ultrasonic energy is passing through the part. Any loss of back reflection MAY be cause for rejection, unless it can be shown that the loss of back reflection is due to a non-parallel back surface or back surface roughness. If back surface roughness is found to be the cause of the back reflection loss and cannot be eliminated, the entire test item SHALL be inspected with another technique to assure conformance to the applicable specification or test procedure.

5.5.3.4 Curved Sound-Entry Surfaces. If the test specimen surface is curved beyond certain limits, a plastic shoe is required to match the transducer face to the curved surface ([Paragraph 5.3.4](#)).

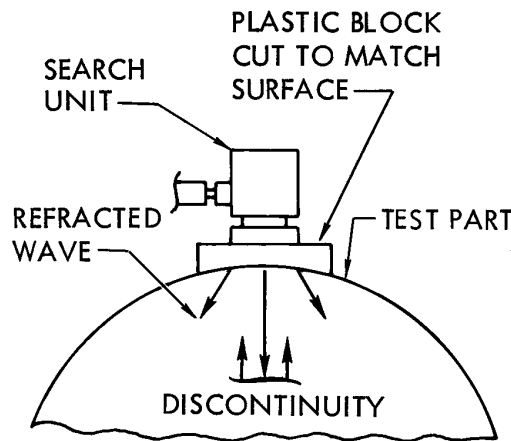
5.5.3.4.1 **Concave and Convex Surfaces.** For a concave surface, the sound beam tends to be focused as it passes into the test part ([Figure 5-65](#)). Depending on the depth in the part, discontinuity signals can be increased in amplitude over signals received from an equivalent discontinuity in a part with a flat sound entry surface.

5.5.3.4.1.1 For a convex surface, the acoustic power that reaches an internal discontinuity is reduced by refraction at the test surface ([Figure 5-66](#)). Signals received from a discontinuity have less amplitude than signals received from the same size discontinuity in a test specimen with a flat sound entry surface.



H0402897

Figure 5-65. Concave Sound Entry Surface



H0402898

Figure 5-66. Convex Sound Entry Surface

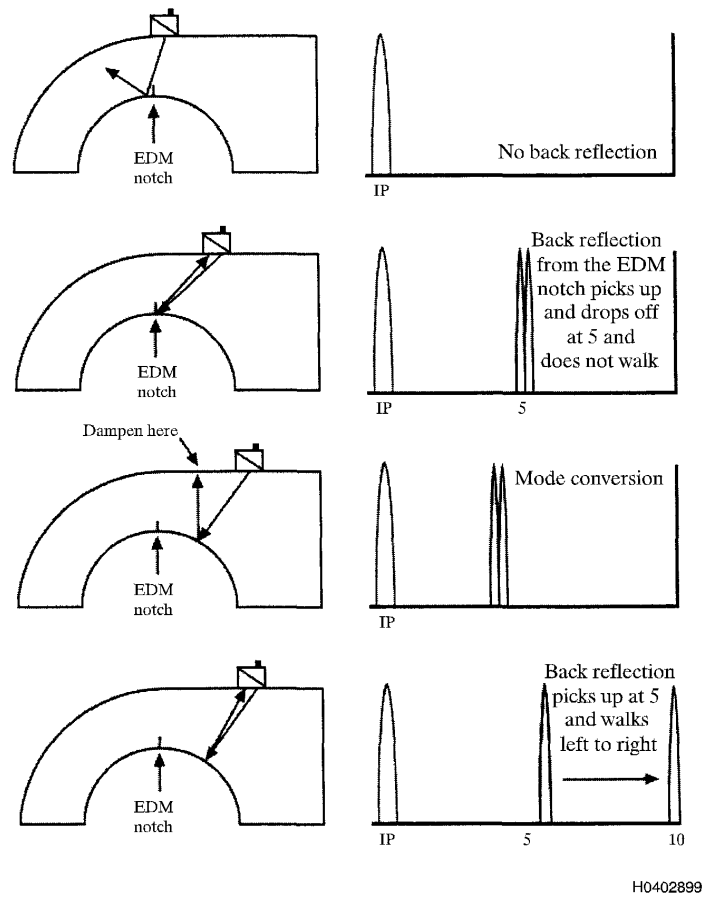
5.5.3.4.2 Because of the variation in a signal due to curved surfaces, it is best to have a curved surface reference standard for setup of the test. The curved surface of the reference standard SHOULD be similar to the curved surface of the test part. Specifically, when performing straight beam inspection on curved surfaces of cylindrical or irregularly shaped products, special ultrasonic test blocks containing specified radii of curvature and flat-bottom holes of standard diameter, may be required. For inspecting parts with convex surfaces or radii up to 4-inches (8-inch diameter), blocks conforming to the ap-

plicable specification or procedure SHALL be used. For parts with convex radii over 4-inches, use standard flat face blocks. For more information see ASTM standout E-1315 for steel blocks (ultrasonic examination of steel with convex cylindrical curved entry surfaces.)

NOTE

When shoes are fabricated from the same material as the test part, the sound will propagate straight into the test part. Refraction does not occur because the velocity in the shoe equals the velocity in the test part. For immersion techniques, no shoe is required, but refraction will be greater than illustrated in [Figure 5-65](#) and [Figure 5-66](#).

5.5.3.5 Internal Mode Conversion. A frequently misinterpreted form of mode conversion found in the field is shear wave converted to longitudinal. For example, on an H-3 sleeve and spindle inspection using a 45 ° transducer to inspect a large radius or bore, a non-relevant indication occurs in the area of interest as a result of this conversion ([Figure 5-67](#)). At a certain transducer position, part of the shear wave will convert to longitudinal as it reflects from the bore. This longitudinal wave ([Paragraph 5.2.3.1](#)) will travel at double the velocity of the shear wave and will be reflected to the surface, then back to the bore. It then returns to the transducer to cause a non-relevant indication similar to a crack indication. In this case, finger damping the part surface where the longitudinal wave reflects off of the part surface in front of the transducer will identify the indication as non-relevant.



H0402899

Figure 5-67. Example of Mode Conversion

5.5.3.6 Internal Structure. Discontinuities inherent in the test article, such as grain boundaries, affect the ultrasonic test by scattering the ultrasonic energy. This reduces the energy available for finding detrimental discontinuities and causes “noise” in the waveform presentation. Effects on an inspection increase as the frequency is increased and are most noticeable in mate-

rials with relatively large grain size. In certain applications, the loss in ultrasonic energy caused by internal scattering can be measured to evaluate metallurgical structures.

5.5.4 Discontinuity Variables. Ultrasonic beams can be reflected at various angles at the discontinuity interface; and can also spread or focus depending on the shape of the discontinuity.

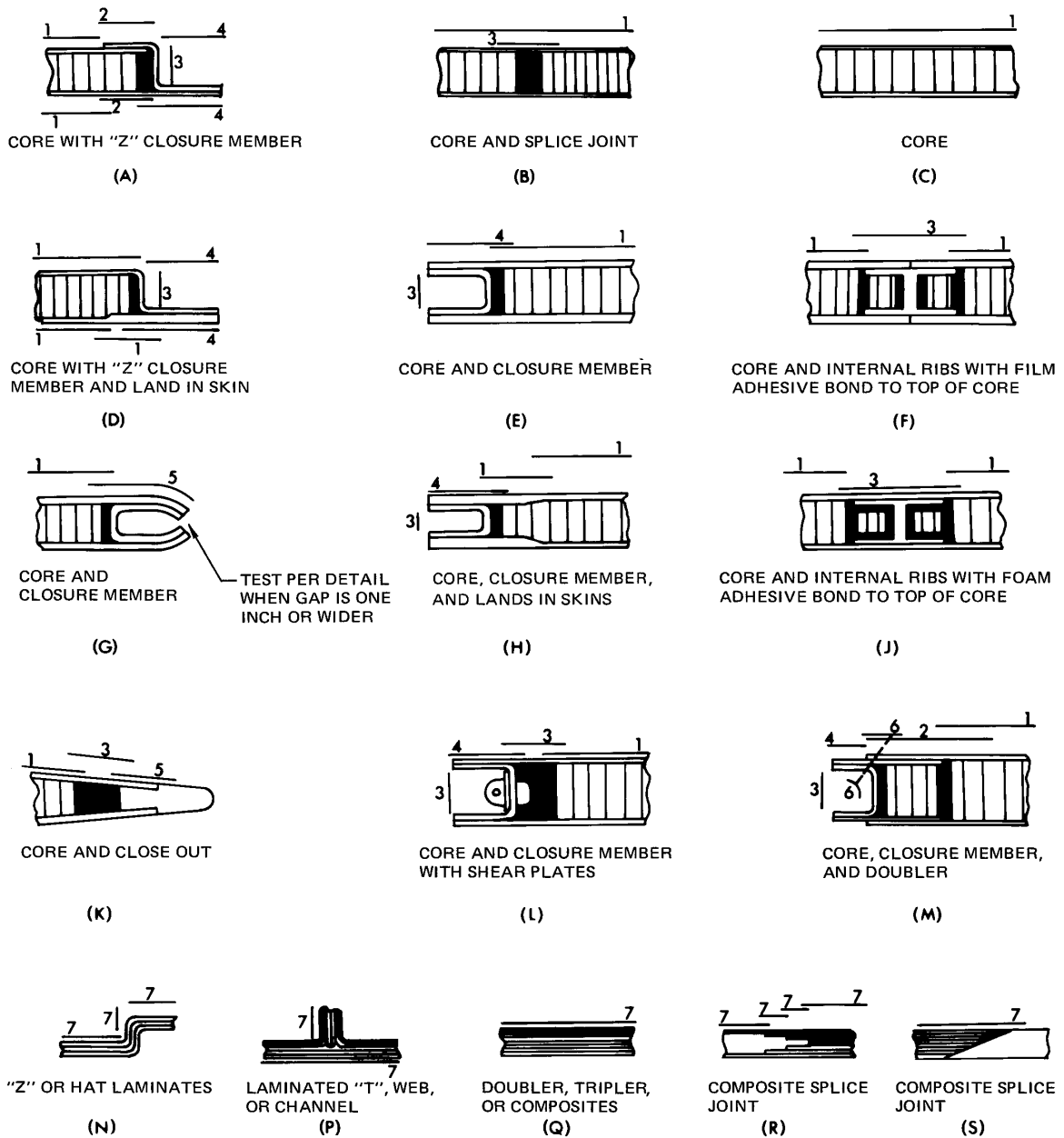
5.5.4.1 Size and Shape. When discontinuities smaller than the sound beam are oriented with one surface perpendicular to the incident sound beam, the amplitude of a reflected ultrasonic beam from a discontinuity increases as the area of the surface normal to the incident sound beam increases. An irregularly shaped or round discontinuity reflects sound energy at many angles, thus resulting in a loss of sound energy back to the transducer. Discontinuities that are flat and perpendicular to the sound beam will reflect the greatest amount of sound energy back to the transducer.

5.5.4.2 Orientation. Discontinuities with surfaces oriented at angles other than perpendicular to the sound beam reflect only a portion (if any) of the sound beam back to the transducer. Consider utilizing an angle beam inspection or employing a straight beam inspection from another surface if discontinuities are suspected to be located at angles other than parallel to the entry surface. To help in detecting discontinuities oriented at angles to an incident straight beam, it may be helpful to monitor the back surface reflection. A sudden decrease in back reflection when scanning could indicate a discontinuity or possibly a number of small discontinuities. If a discontinuity signal is observed which is proportional to the loss in back reflection, the discontinuity is probably flat and oriented normal to the incident sound beam. If the discontinuity signal is small in relation to the loss of back reflection signal, the discontinuity is probably turned at an angle to the incident sound beam or is rounded. A decrease in back reflection accompanied by multiple discontinuity signals or a general increase in the noise level MAY indicate the presence of multiple discontinuities.

5.5.4.3 Acoustic Impedance. The acoustic impedance of the discontinuity material in relation to the acoustic impedance of the test part is important. The reflections from an air interface such as a crack or void are large due to the acoustic impedance ratio. If a discontinuity had acoustic impedance close to the acoustic impedance of the test material, the acoustic impedance ratio would be small and very little reflection would occur. When an ultrasonic beam strikes a boundary between two different materials, part of the energy is transmitted to the second medium and a portion is reflected. The percentage of sound energy transmitted and reflected is related to the ratio of the acoustic impedances of the two materials. The acoustic impedance calculation is shown in [Paragraph 5.7.7](#).

5.5.4.3.1 Determining Reflected Energy at an Interface. Acoustic impedance can be used to calculate the theoretical reflected and transmitted energy for an interface. The greater the difference in acoustic impedance across the interface, the greater amount of sound reflected. The theoretical reflection at a water-steel interface is 88-percent; at a water-aluminum interface it is 72-percent; however, the actual reflection often differs significantly from the calculated theoretical reflection. Surface roughness is one of the variables besides acoustic impedance that affects the percentage of reflection. The acoustic impedance of the discontinuity material in relation to the acoustic impedance of the test part is important. The reflections from an air interface, such as a crack or void, are large due to the acoustic impedance ratio. If a discontinuity had acoustic impedance close to the acoustic impedance of the test material, the acoustic impedance ratio would be small and very little reflection would occur. The formula used to determine the amount of reflected energy that occurs at an interface is located in [Paragraph 5.7.7.1](#).

5.5.5 Inspection Coverage of Bonded Structures. Examples of bonded structures, along with suggested inspection coverage, is shown in [Figure 5-68](#). The ultrasonic inspection methods applicable to the numbered coverage shown in the figure are listed in [Table 5-1](#). Due to access limitations, it will not be possible, in many cases to apply the inspections in all the areas shown. These coverages and associated methods are guidelines only. Details of inspection coverage and inspection methods for a particular assembly SHALL be obtained from the applicable NDI manual or the depot engineering activity.



1. THE NUMBERED LINES SURROUNDING EACH VIEW INDICATE THE SCAN PLANES. THE NUMBER ON EACH LINE IS USED TO DETERMINE THE ACCEPTABLE INSPECTION METHODS BY REFERRING TO TABLE 5-1.
2. WHERE SURFACES ARE SYMMETRICAL, THE COVERAGE ILLUSTRATED SHALL BE CONSIDERED TYPICAL FOR BOTH SIDES.
3. SHADED AREAS (■) REPRESENT FOAM ADHESIVE.
4. WHEN THE SAME METHOD(S) ARE SPECIFIED IN MORE THAN ONE SCAN PLANE, CALIBRATION SHALL BE VERIFIED FOR EACH PLANE.

H0402900

Figure 5-68. Bonded Structure Configurations and Suggested Inspection Coverages

Table 5-1. Ultrasonic Inspection Techniques for Bonded Structures

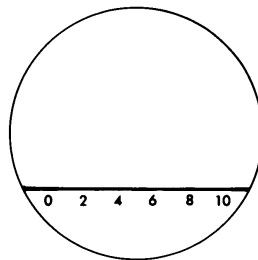
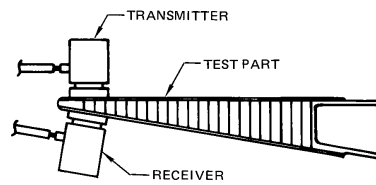
Scan Line Number	Applicable Methods	
1	<u>Near-Side Skin-to-Core</u> a. Pitch/Catch b. Mechanical Impedance Analysis c. Resonance d. Eddy-sonic e. Through-transmission f. Pulse-echo g. Ringing	<u>Core Damage</u> a. Mechanical Impedance Analysis b. Through-transmission c. Pulse-echo <u>Far Side Skin-to-Core</u> a. Mechanical Impedance Analysis b. Through-transmission
2	<u>Near-Side Skin-to-Core</u> a. Resonance b. Mechanical Impedance Analysis c. Through-transmission d. Ringing <u>Core Damage</u> a. Mechanical Impedance Analysis b. Through-transmission	<u>Far-Side Skin-to-Core</u> a. Mechanical Impedance Analysis b. Through-transmission
3	a. Resonance b. Mechanical Impedance Analysis	c. Ringing
4	a. Resonance b. Ringing	c. Through-transmission d. Ringing
5	a. Resonance	b. Ringing
6	a. Through-transmission (with fluid delay lines)	
7	a. Resonance b. Mechanical Impedance Analysis	c. Through-transmission d. Ringing

5.5.6 **Inspection Methods for Bonded Structures.** Ultrasonic bond inspection techniques, along with advantages and limitations of each technique, are provided in [Table 5-2](#). Additional information on each technique is provided in the following paragraphs.

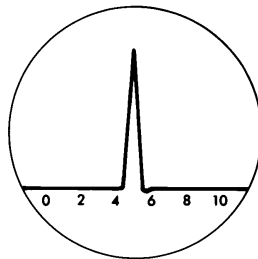
Table 5-2. Ultrasonic Inspection Techniques for Bonded Structures

Inspection Method				
	Through Transmission	Pulse-echo	Ringling	Damping
Advantages	Applicable to structures with multiple layers, with or without honeycomb. Detects disbonds between any layer or in honeycomb. Detects small defects (larger than the diameter of receiving search unit).	Applicable to honeycomb structures with thick or thin skins. Detects small disbonds (search unit diameter and smaller).	Applicable to complex shapes. Detects small near-surface disbonds (larger than diameter of search unit).	Applicable to multi-layered structures with thick or thin sheets. Detects disbonds between any layers. Detects small disbonds (larger than diameter of search unit).
Limitations	Access to both sides of part required. Does not determine layer position of disbonds. Alignment of search units is critical. Couplant is required. Inspection rate is slow.	Inspection from both sides required. Does not detect far-side disbonds. Applicable only to honeycomb sandwich structures, usually those with single-layer skins. Couplant is required.	Applicable only to near-surface disbonds. Works best on disbonds between top sheet and adhesive layer, may miss disbonds on other side of adhesive. Works best on metals. Couplant required.	Applicable only to laminated (non-honeycomb) structures. Access to both sides is required. Does not determine layer position of disbond. Couplant is required.
	Resonance	Pitch-Catch	MIA	Eddy-Sonic
Advantages	Locates layer position of disbonds. Applicable to laminate or honeycomb structures. Applicable to complex shapes.	No couplant required, potential for faster scanning. Special displays make interpretation easier.	No couplant required. Can be used on irregular or curved surfaces. Most effective on honeycomb structures: skin-to-core disbonds and core defects.	No couplant required, potential for faster scanning.
Limitations	Inspection required from both sides of honeycomb structures. Couplant required.	Reduced effectiveness for disbonds greater than 0.80 inch below inspection surface. Access to both sides of honeycomb required. Probe is directional with respect to locating boundaries of disbonds.	Reduced effectiveness on purely laminated structures.	Works only on metals. Reduced effectiveness for disbonds farther from inspection surface and for low conductivity metals (titanium).

5.5.6.1 Through-Transmission Technique. The principle of this technique is shown in [Figure 5-69](#). Delaminations in either skin, disbonds between skin and core, and core damage prevent the transmission of sound to the receiving transducer. The minimum size flaw detected is proportional to the size of the receiving transducers. The received signal does not have to disappear completely to indicate a flaw. Any flaw large enough to lower the received signal noticeably can be detected. Care SHALL be taken to move both transducers in tandem; otherwise, misaligned transducers will generate false indications.



NO SIGNAL
(UNBOND)



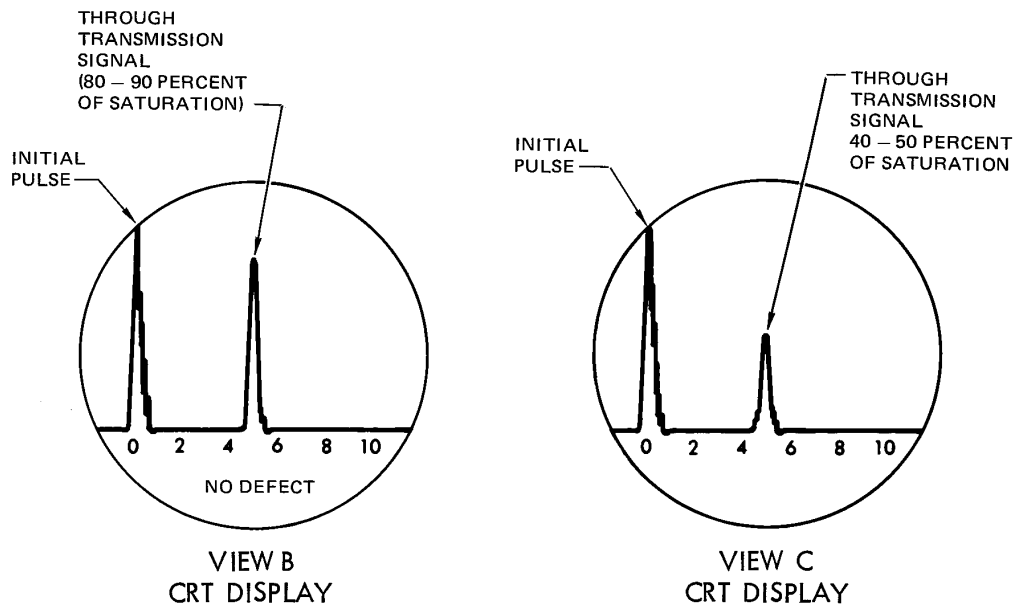
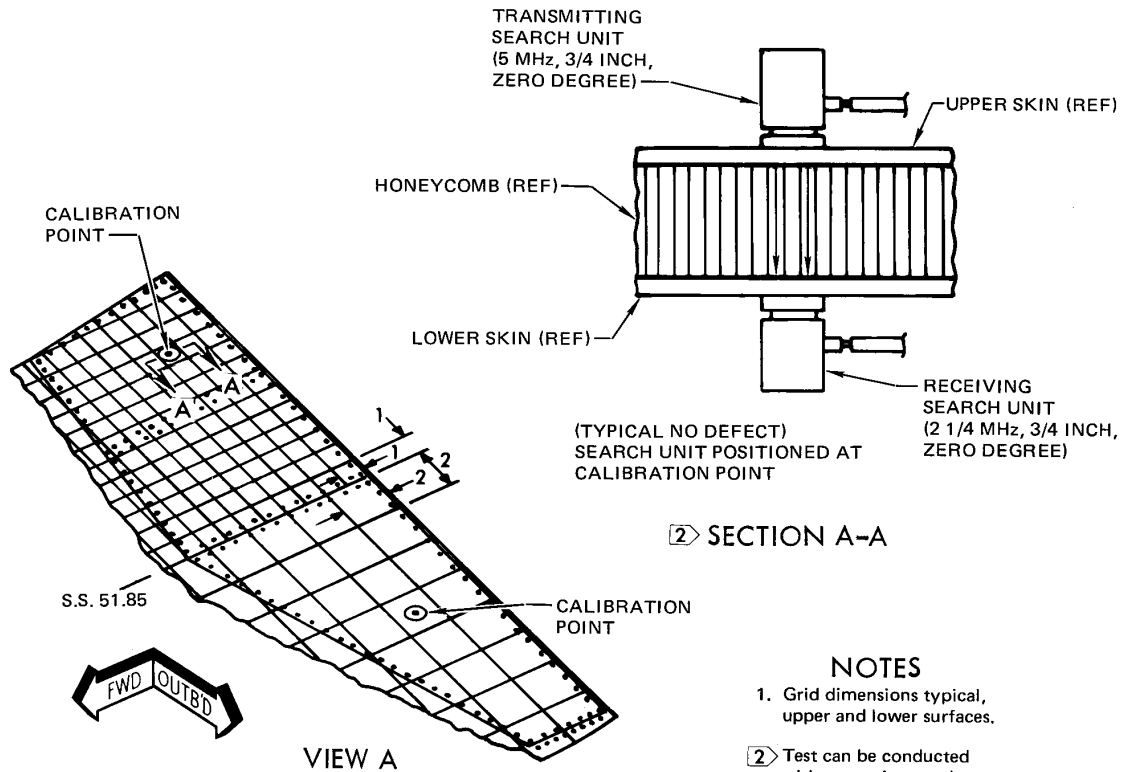
RECEIVED SIGNAL
(BOND)

HO402901

Figure 5-69. Through-Transmission Technique

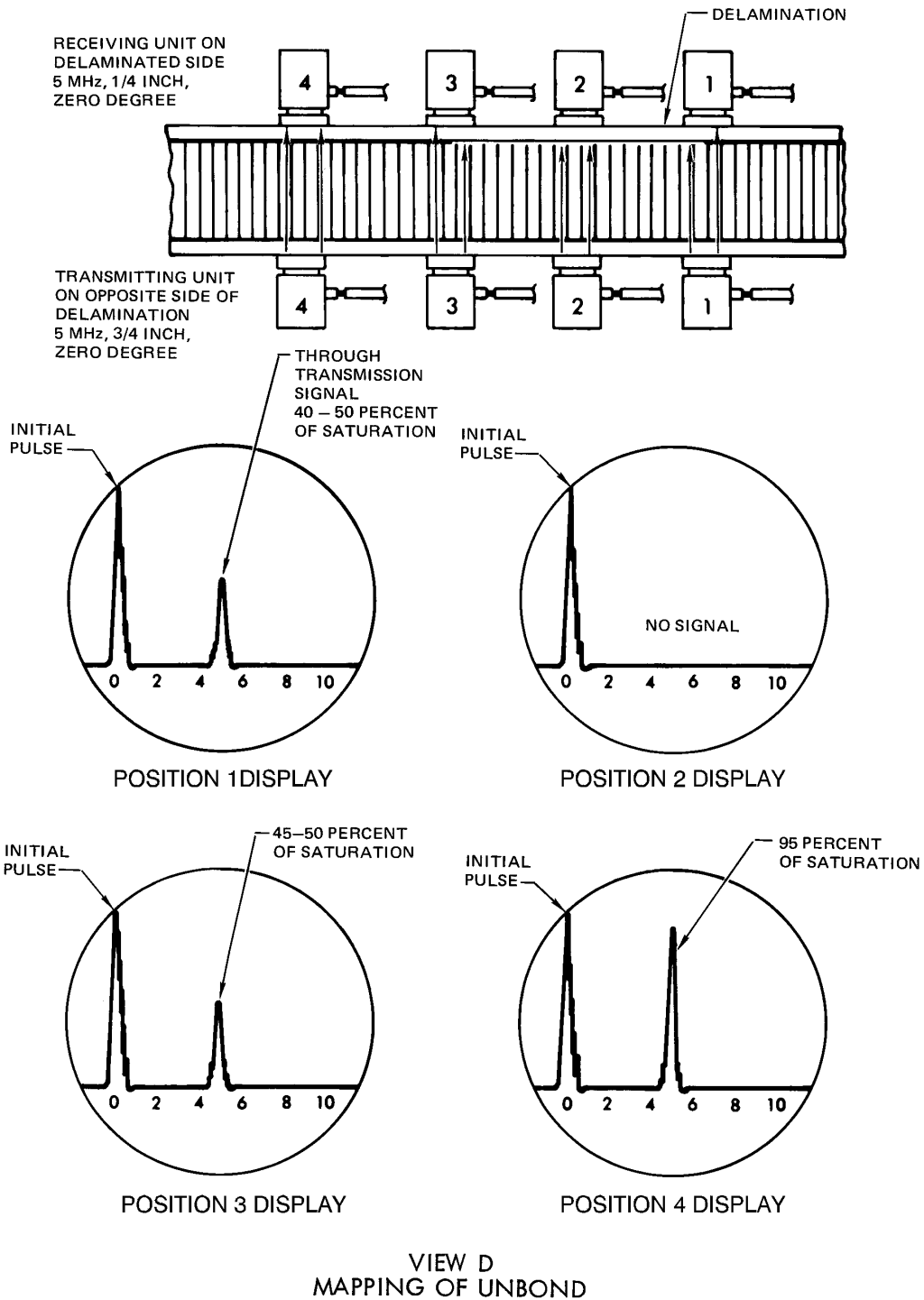
5.5.6.1.1 Through Transmission Example. The structure is an aluminum honeycomb sandwich structure. Grids are marked on the surfaces to aid in maintaining transmitter/receiver alignment mapping boundaries of suspected flaws, assuring complete inspection coverage. The grid sizes are proportional to the critical flaw size of the respective zones. During the inspection one transducer is placed in the center of a grid square and the other is manipulated to maximize the received signal, as indicated in view B (Figure 5-70). Each square is inspected in turn. If the through-transmission signal falls below 50-percent of saturation, as indicated in view C (Figure 5-70), couplant and transducer alignment SHOULD be checked. If there is a definable area where the signal is less than 50-percent, mark the boundary (at the centerline of the receiving transducer) where the signal equals 50-percent according to the procedure in view D (Figure 5-71).

5.5.6.2 Pulse-Echo Technique. The basic principle of this technique is shown in Figure 5-72. It employs an angle beam transducer because straight beam transducers can produce multiple echo signals from the layers that would interfere with echo signals from the core. This method is applicable only to honeycomb structures and is best applied to structures with single-layer skins as indicated in detail C (Figure 5-68) when the through-transmission technique cannot be used. Straight beam transducers could provide better results on structures with multi-layer skins. This technique SHOULD be used as a backup to techniques associated with dedicated bond inspection instruments discussed below. Angle beam transducers producing refracted angles of 30° to 90° MAY be used. The angle selected SHOULD be the one that produces the maximum signal response from the back of the core.



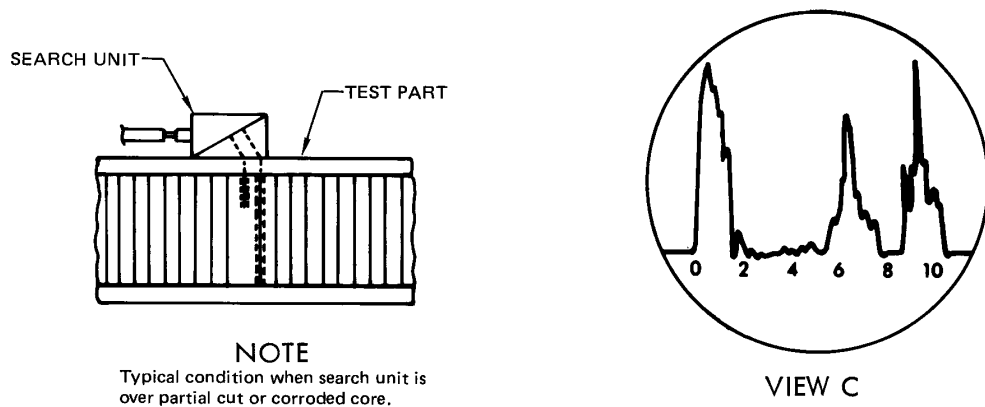
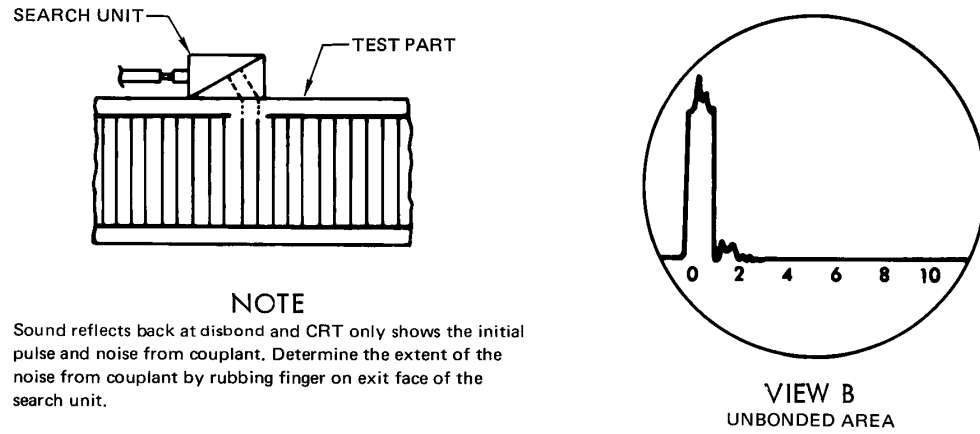
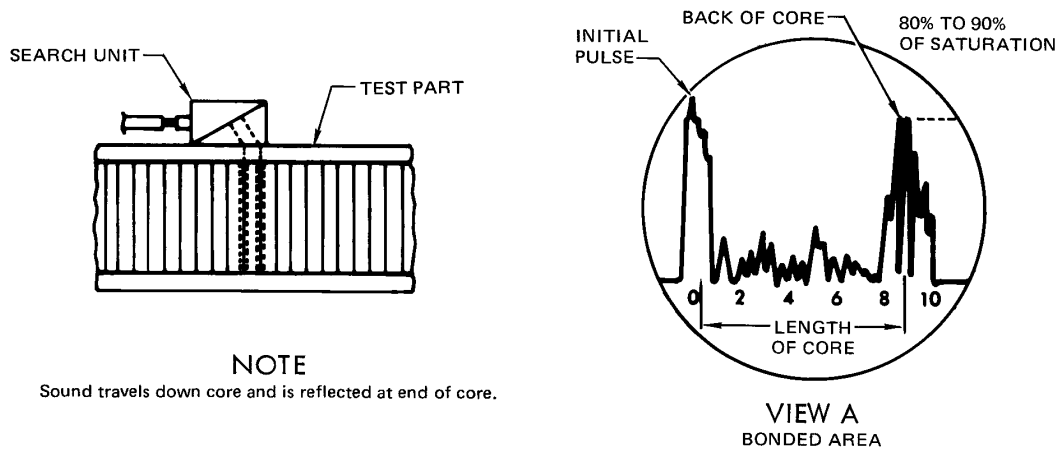
H0402902

Figure 5-70. Procedure for Through-Transmission Inspection of a Stabilator View A - C



H0402903

Figure 5-71. Procedure for Through-Transmission Inspection of a Stabilator View D

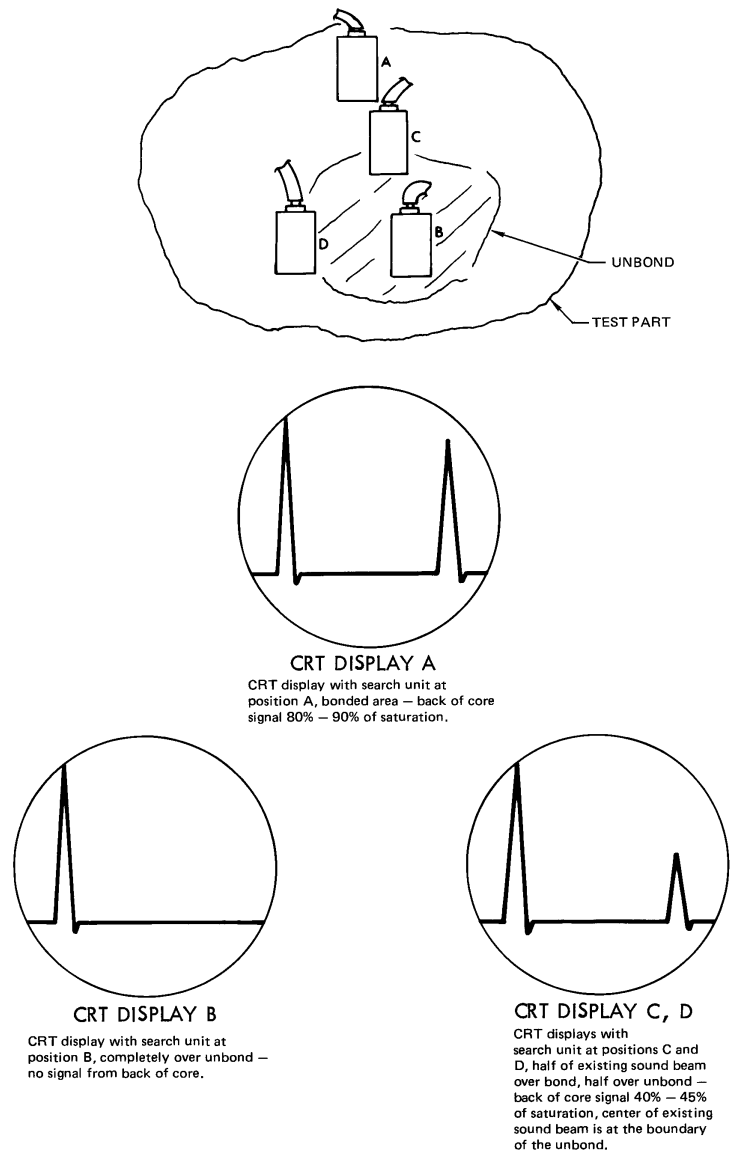


H0402904

Figure 5-72. Pulse-Echo Technique

5.5.6.2.1 This technique can detect near-skin-to-core disbonds and broken or corroded core. Disbonds will cause a complete loss of the signal from the back of the core as indicated in view B (Figure 5-72). Broken or corroded core will reduce or completely eliminate the signal from the back of the core and can produce an echo signal as indicated in view C (Figure 5-72).

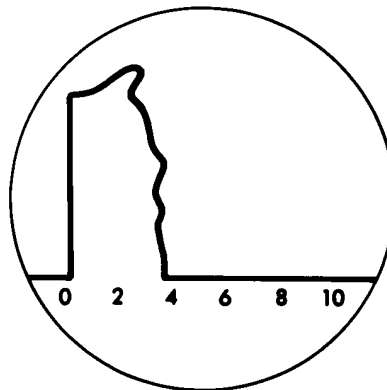
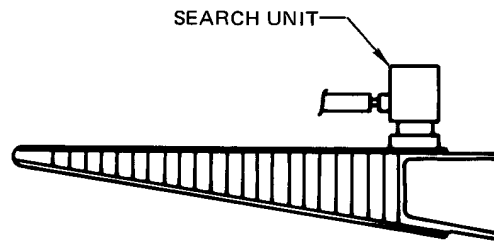
5.5.6.2.2 Indications MAY be mapped by marking the boundaries, where the back echo signal drops below 50-percent of the amplitude obtained in a good area (Figure 5-73).



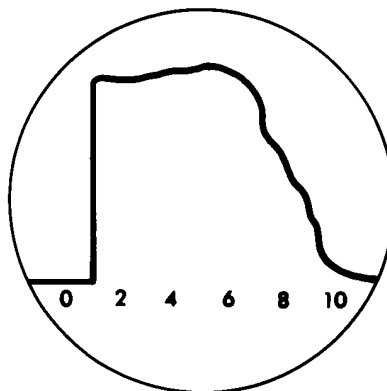
H0402906

Figure 5-73. Mapping of Disbonds, Pulse-Echo Technique

5.5.6.3 Ringing Technique. The principle of this technique is shown in Figure 5-74. The A-scans in the figure represent the outline of multiple echo signals from the skin that cannot be individually resolved. This technique is most sensitive to disbonds between a single layer of skin and the adhesive layer. A disbond between the adhesive and the core, or another layer of skin or a doubler, will often not produce a ringing signal because the adhesive bonded to the top sheet dampens the signal. Because of this limitation, it is recommended that this technique be applied only when one of the other techniques is not applicable. A good application for this technique is the inspection of core-to-closure-member bonds.



DAMPED SIGNAL
FROM BONDED AREA



RINGING SIGNAL
FROM UNBONDED AREA

H0402907

Figure 5-74. Ringing Technique

5.5.6.4 Damping Technique. When a finger, wet with couplant, is placed on the interface that sound is reflecting from the acoustic impedance ratio is altered causing the ultrasonic response to decrease in amplitude. As illustrated in [Figure 5-75](#), as sound passes through the component to the backside of the of the component, the sound is reflected from the material-to-air interface. When an inspector places a finger wet with couplant at this location, the acoustic impedance ratio changes to material-to-water, thus more sound is passed THROUGH the interface resulting in a lower amplitude being displayed. When the inspector removes their finger from the interface, the acoustic impedance ratio returns to material-to-air,

thus increasing the amount of sound that is reflected at the interface resulting in a higher amplitude signal being displayed. This technique is effective for laminate, doubler, and skin-to-closure-member bonds when access to the backside is available. If the inspector can dampen the multiple echoes from the far side of the bonded structure with a wet finger, then the bond is good. Otherwise, the sound is being reflected by a disbond and is not reaching the far surface, so it cannot be damped. Disbonds equal to or larger than the size of the transducer are easily detected.

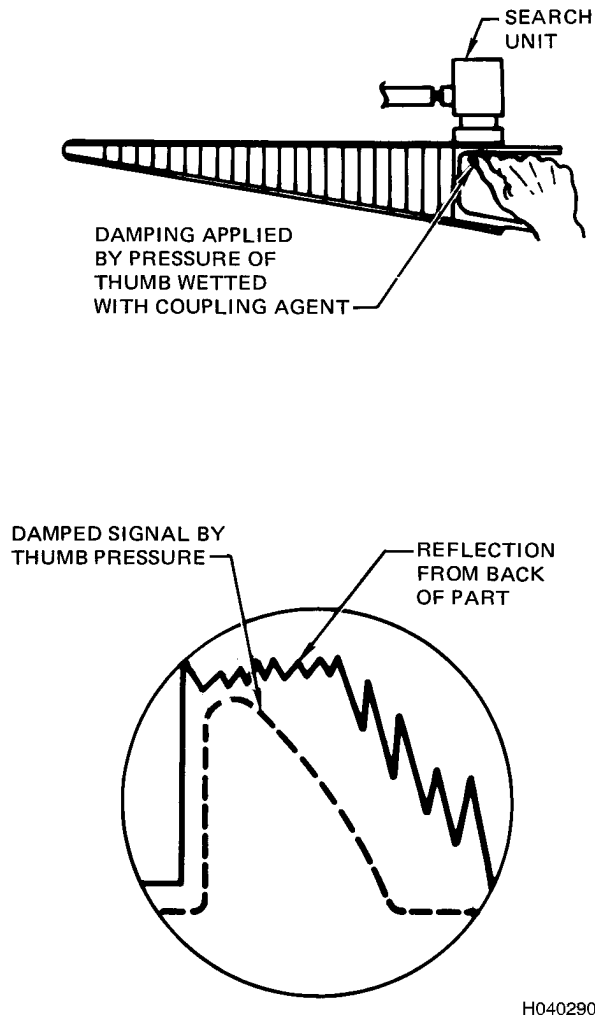
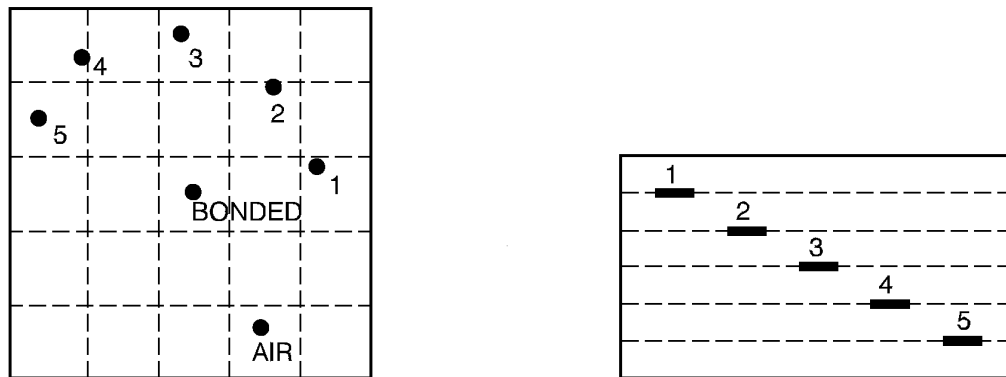


Figure 5-75. Damping Technique

5.5.7 Techniques Associated With Instruments Dedicated to Bond Inspection. Refer back to the bottom half of [Table 5-2](#) for a summary of these methods, which are described in detail below.

5.5.7.1 Resonance Technique. When an ultrasonic transducer is placed on a test sample, with couplant, it is driven at its resonance frequency by an oscillator in the instrument. The detector in the instrument measures the phase and amplitude components of the electrical impedance of the probe, which are affected by changes in the acoustic impedance of the test part. The acoustic impedance of a part is altered by a lack of bond, commonly referred to as delamination. Bonded laminates act like a thin plate, which vibrates and generates a standing wave. Changes in the effective thickness caused by the delaminations will significantly affect the phase and amplitude of the acoustic wave in the part. With the resonance technique, the instrument indicates the probe's impedance with a "flying spot" on an ultrasonic impedance plane display. Amplitude changes in impedance are indicated by the radial distance of the "flying spot" from the center of the display (null reference point), and changes in the phase are indicated by the rotation of the flying spot around the center null point. An example of an ultra-

sonic impedance plane display (Figure 5-76) “A” shows the “flying spot” positions corresponding to different depths of disbonds (delaminations) in the bonded laminate in Figure 5-76 “B” The laminate is an example of a typical reference standard used for calibration. The positions can be gated, so a disbond produces an alarm, or the display can be monitored to determine between which layers a disbond occurs. The resonance mode works very well for detecting disbonds at metal-to-metal, metal-to-composite, and composite-to-composite interfaces, for finding delaminations within composite materials, and for detecting skin-to-core disbonds in honeycomb sandwich structures.



A) RESONANCE DISPLAY OF UNBONDS IN LAMINATE SHOWN AT RIGHT

B) MULTI-LAYERED LAMINATE WITH UNBONDS

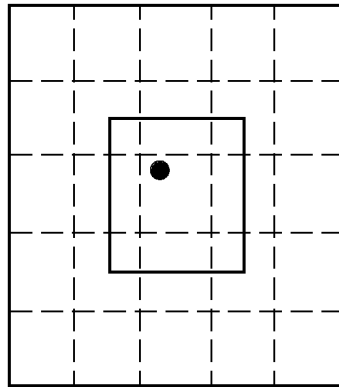
H0402909

Figure 5-76. Resonance Method

5.5.7.2 Pitch/Catch Impulse Method. The pitch/catch method uses a pair of transducers displaced from each other by a fixed distance. The transducers are placed on the same or opposite sides of the part. A single ultrasonic frequency is transmitted into the part by one transducer; a second transducer in the same probe assembly receives the returned signal. Contact with the part is made through nylon wear tips on spring-loaded metal rods attached to the respective transducers. The ultrasound travels through the material between the two probe tips. Depending on the instrument, the received signals are displayed in various ways:

- Amplitude and phase components are displayed on separate meters.
- The resultant signal activates a light-emitting-diode (LED) display.
- The phase and amplitude components are combined to position a “flying spot” on an impedance plane display.

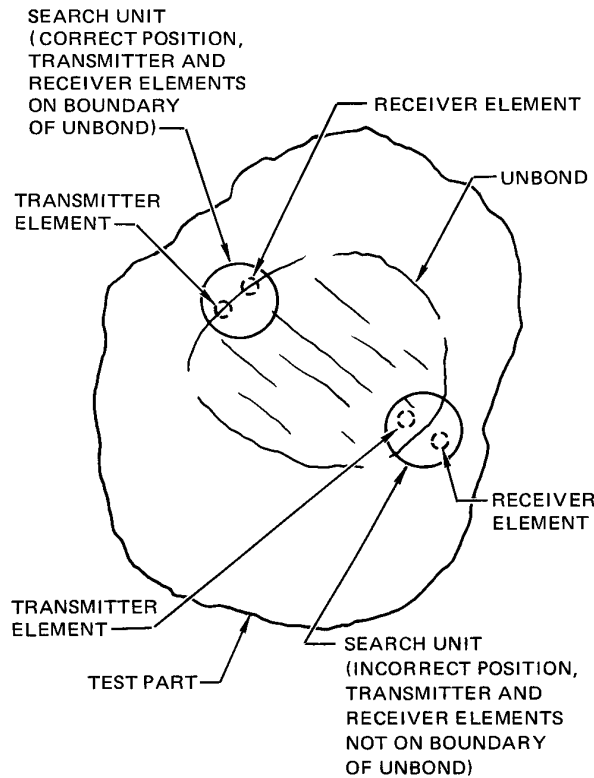
The display in Figure 5-77 shows a box in the middle of the display, which is the gate that sets off an alarm if the “flying spot” lands inside, indicating a disbond.



H0402910

Figure 5-77. Impedance Plane Display of a Pitch/Catch Impulse Technique

5.5.7.2.1 The pitch/catch impulse probe is directionally sensitive, such that both active tips must be over the same condition of bond for unambiguous signal interpretation. For example, [Figure 5-78](#) shows the proper way to align the active tips for precise mapping of disbonds.

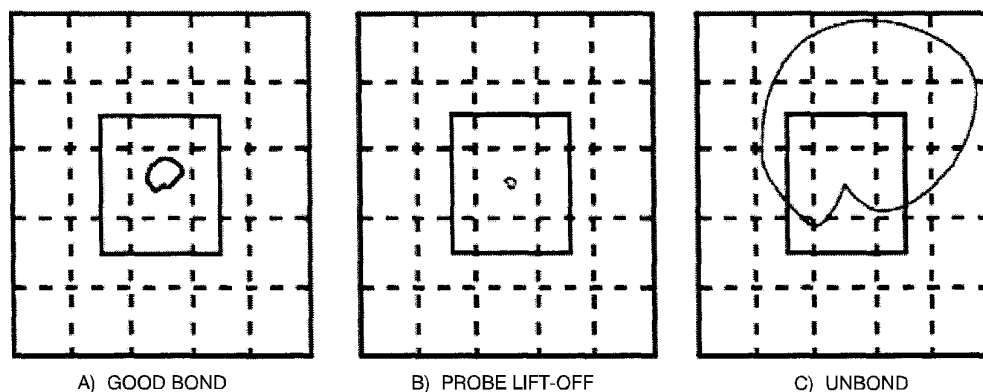


H0402911

Figure 5-78. Pitch/Catch Probe Positions for Mapping Disbonds

5.5.7.2.2 Some pitch/catch instruments permit the operator to select the frequency, while in others the frequency are fixed. Typically, selectable frequencies range from 2.5 to 70 kHz; the frequency providing the largest received signal, due to maximum flexure in the layer being tested, is chosen for the inspection. A typical fixed frequency is 25 kHz. The low frequencies eliminate the need for liquid couplant between the transducer and the test part. On some instruments, a variable time gate is used to select the part of the received pulse that has the greatest change in amplitude when the probe is moved from a bonded area to a disbonded area. The amplitude will be larger over the disbonded area than a bonded area because the motion of the layer is restricted over a bonded area and energy is lost into the second layer. The pitch-catch mode works on composite delaminations, skin-to-core disbonds, and metal-to-metal disbonds. The technique tends to lose its effectiveness if the material thickness between the probe and the delamination exceeds 0.08-inch of aluminum or 0.30-inch of nonmetallic composite. In addition, the minimum dimension of a detectable flaw is greater than or equal to the probe tip spacing.

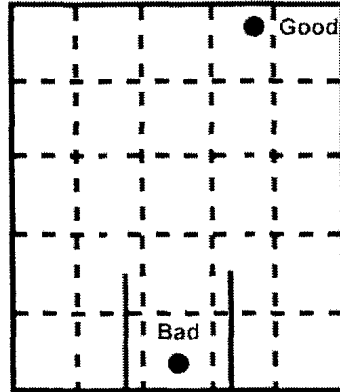
5.5.7.3 Pitch/Catch Swept Frequency Technique. Instead of a single frequency, each pulse contains a range of frequencies (e.g., 20 - 40 kHz or 30 - 50 kHz), generating ultrasonic Lamb (plate) waves within the part. These waves are attenuated by coupling into the second layer in well bonded joints. In a disbonded region, the waves travel with very little attenuation or leakage into the second layer and produce larger indications. Both the swept and impulse techniques will find similar types of defects; however, with the swept technique, calibration interpretation of the signals are easier because both the amplitude and phase signals are simultaneously displayed in the form of circular patterns on one X-Y active screen. Instrument displays corresponding to three situations detected with the Pitch/Catch Swept-Frequency Technique are shown in [Figure 5-79](#).



H0402912

Figure 5-79. Pitch/Catch Swept-Frequency Signal Patterns

5.5.7.4 Mechanical Impedance Analysis (MIA) Technique. The driver portion of a single-tip dual-element probe generates low-frequency sound waves that transfer to mechanical movements in the test material. The stiffness and mass of the material are measured by the receiving sensor, and displayed in terms of both phase and amplitude values. The receiver element at the bottom of the probe has its loading affected by the part stiffness, which changes from very high over bonded regions to low over disbonded regions. Since the measurements are a comparison of stiffness, results are better on stiff structures. Flexible composites would not have much change in stiffness from bonded to disbonded areas. The MIA mode does not require couplant, and has a small contact area so it can be used on irregular or curved surfaces. The MIA technique seems most suitable for detecting damage associated with honeycomb core such as: skin-to-core disbonds, severely corroded aluminum core, and buckled or crushed core; additionally, disbonds and delaminations also can be detected with this technique. Typical positions of indications produced with the MIA technique are shown in [Figure 5-80](#). During an inspection, only the “flying spot” would be present on the display. The gate box can be positioned anywhere on the display; the appropriate position is determined during calibration.



H0402913

Figure 5-80. Mechanical Impedance Analysis Display

5.5.7.5 Eddy-Sonic Method.



Gradual changes in indications on an instrument display SHOULD be evaluated to see if the part thickness is changing. If the part thickness has changed, recalibration is required. When possible, scanning SHOULD be performed in directions of constant thickness.

Since this method is based on the generation of eddy currents in the test part, it will work only on metal structures. The instrument sends electrical pulses, with frequencies in the low kilohertz range, to a coil in the probe. The resultant pulsating magnetic field produces eddy currents in the part; the eddy currents cause the part to vibrate, and a microphone on the axis of the coil detects the sonic vibrations. Disbonds cause changes in the vibrations of the part. The detected changes produce an indication on a meter or an LED array. The probe usually has a mechanical lift-off adjustment that sets the air gap between the coil and the test surface to minimize the noise produced by probe scanning. This method works best on metallic honeycomb structures with thin skins (0.062 inch or less). Other methods do as well on such configurations, because the eddy-sonic is rather limited in its application, it is not commonly used.

NOTE

For a reliable bond inspection, the inspection surfaces of the test part SHALL be free of loose paint and foreign matter.

5.5.8 Thickness Measurement Test Part Preparation.

5.5.8.1 Surface Contamination. All foreign matter that might interfere with the thickness measurements SHALL be removed. Examples of such matter are loose scale, paint, dirt, and rust. For maximum accuracy, paint SHOULD be removed in the area to be measured. Paint can introduce errors in the measurements up to three times the maximum thickness of the paint. Metallic plating on the surface of the test part (Cr, Cd, Ni, etc.) will not significantly affect the accuracy of the readings; usually, this plating is relatively thin (0.0005-inch).

5.5.8.2 Surface Roughness. The surface finish of the test part affects the accuracy of the reading. If the surface of the test part is pitted or irregular, consistent readings will not be obtained. If permitted by the applicable weapons system manual or the prime depot engineering authority, local areas MAY be sanded to provide a smooth surface for increased accuracy in the thickness measurements.

5.5.9 Thickness Measurement Considerations.

5.5.9.1 Corrosion Pitting. The effect, corrosion pits on the back surface of the test part has on thickness measurements, depends on the size of the pits and the size of the search unit. The depth of large pits (the size of the search unit diameter or greater) can be measured by subtracting minimum readings from maximum readings obtained on adjacent areas of the test part. Smaller pits will generally cause a broadening of the back surface reflection signals, and sometimes a reduction in amplitude due to scattering of the sound beam. These effects can be observed on instruments equipped with waveform displays. Smaller pits also lower the average thickness readings of the test part.

5.5.9.2 Curved Surfaces. Measurements of curved surfaces require reference standards in accordance with [Paragraph 5.4.11.3.3](#). In addition, for convex radii less than 1-inch or concave radii less than 3-inches, shoes are required to adapt the search unit to the curved surface. Detailed procedures for taking the measurements SHALL be obtained from the applicable NDI manual or the depot level engineering activity. On all curved surfaces, it is recommended an instrument with a waveform display be used. Small-diameter transducers (1/4-inch or less) are also recommended. When making a measurement on a curved surface, the back surface signals SHOULD be maximized by rocking the transducer on the surface until the back surface signals peak and the thickness reading is at a minimum. The minimum thickness reading SHOULD be recorded as the test part thickness.

SECTION VI ULTRASONIC INSPECTION PROCESS CONTROLS

5.6 INTRODUCTION.

5.6.1 Ultrasonic Process Control Requirements. In the ultrasonic inspection process, like all other processes, you must know your equipment is functioning properly. Frequency of process control checks on equipment SHOULD come from the operations manual on the equipment. Frequency of transducer checks SHOULD be determined by the amount of use. The operator is the critical link in this process. Even if all the equipment is working properly, the inspector must follow the written procedure and use the correct standard. Deviations SHALL NOT be made without proper engineering authority. In this chapter, the terms "reference standard," "reference block," "test block," and "calibration standard" all have the same meaning as defined in the glossary. Reference standards are used by the instrument operator. Calibration of reference standards by laboratories is not required; however, to ensure uniform inspection sensitivity, reference standards SHALL be traceable to a "master standard" in terms of discontinuity response. Minimum interval frequency for process control checks on equipment and transducers are stated in TO 33B-1-2 WP 105 00.

5.6.1.1 Required Use. All inspections SHALL include the use of one or more reference standards for setting up an inspection. In addition, all discontinuity indications SHALL be compared to a reference standard by comparing the signal amplitude of the discontinuity with the signal amplitude of the reference standard. This is done either in percent signal amplitude, or by noting the difference in amplitude in decibels (dB) when the instrument is equipped with dB attenuation controls.

5.6.2 Reference Standard Configuration. A reference standard for metals MAY be a block containing a flat-bottom or side drilled hole with a known size, a machined slot or notch, or an actual test part or similar manufactured part with an actual or simulated discontinuity of known size. For composite parts, a reference standard SHOULD adequately simulate the ultrasonic response from the part as well as the response from the expected defect types. For inspections of metals, the following guidelines should be considered when designing an inspection and specifying or designing the appropriate reference standard.

- ASTM standard practices E-127, E-428, and E-1158 should be followed when applicable.
- Curved surface reference standards MAY be required when performing straight beam inspection of curved entry surfaces on cylindrical or irregularly shaped products. Special ultrasonic test blocks containing specified radii of curvature, flat-bottom holes, EDM slots, or other simulated defects should be used. For parts with convex radii over 4-inches, use standard flat face blocks. Flat blocks MAY also be used to inspect other curved surfaces when supported by test data showing adequacy, with correction factors as applicable, and must be acceptable to the responsible engineering activity.
- International Institute of Welding (Type 2 IIW) blocks and/or miniature angle beam blocks SHALL be used as specified for determining certain characteristics of angle beam and straight beam transducers and MAY be used for distance calibrations. Refer to TO 33B-1-2 WP 105 00.

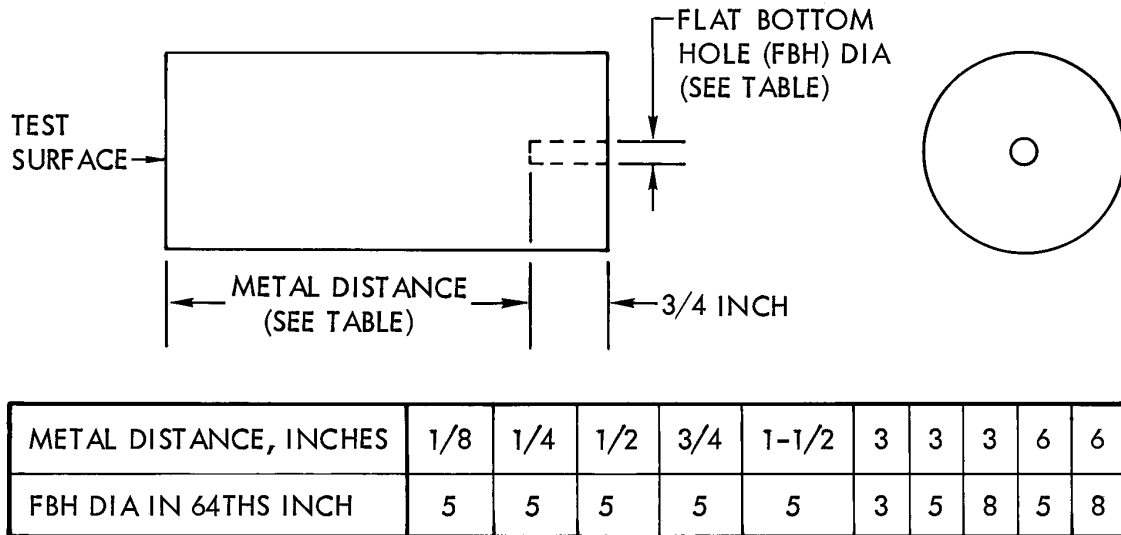
- Holes, notches, and other reflectors SHALL be protected against corrosion and mechanical defacing that would alter the ultrasonic echo signal. For example, it is recommended all holes be sealed to prevent corrosion of the holes, reflecting surfaces.
- For most inspections performed to locate cracks, an effective reference standard can be made by electrical discharge machining (EDM) notches. Notch dimensions must be verified before initial use. The notch of appropriate size SHOULD be placed in the expected location of cracks with the plane of the notch in the expected plane of cracks. Information on the expected location and orientation of cracks SHALL be obtained from the cognizant engineering authority. Other reflecting surfaces meeting the requirements of SAE AMS STD 2154 or ASTM E2375 are permitted. All standards SHOULD be clearly identified so that the material, hole or notch size, angles, and dimensions are clear.
- For some applications, like thickness measurement or back surface corrosion detection in metals; or delamination or disbond detection in composites, a known-thickness or known-good area on the part being inspection can serve as a calibration or reference standard.
- In some applications, in both metals and composites, where a suspect indication is being evaluated, the response from the same location on another identical aircraft can be useful as a reference specimen for response comparison.

5.6.2.1 **Metal Travel Distance.** The metal travel distance (distance from sound-entry surface to a discontinuity) for the test part and the reference standard must be the same within the tolerances shown in [Table 5-3](#); or distance amplitude correction should be considered.

Table 5-3. Reference Standard Metal Travel Tolerances

Metal Travel Distance to Discontinuity in Test Part (inches)	Tolerances on Metal Travel Distance to Discontinuity in Reference Standard (inches)
Up to 1/4	±1/16
1/4 to 1	±1/8
1 to 3	±1/4
3 to 6	±1/2
Over 6	±10% of metal travel

5.6.2.2 **Straight Beam Reference Standards.** The ASTM test block configuration is shown in [Figure 5-81](#). Two sets of ASTM test blocks, one for aluminum and one for steel, are included in AS 455. Two ASTM specifications cover manufacturing and verification of these reference standards. They are ASTM E-127 (aluminum test blocks) and ASTM E- 428 (steel test blocks). ASTM E-428 also allows the use of reference standards of other materials such as titanium. For more information see ASTM E-1158, “*Standard Guide for Material Selection and Fabrication of Reference Blocks for the Pulsed Longitudinal Wave Ultrasonic Examination of Metal and Metal Alloy Production Material*.”



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Figure 5-81. ASTM Reference Blocks

- a. When applicable, [Table 5-4](#) MAY be used as an aid if the required flat-bottom hole, (FBH), reference standard is not available. The second column lists relative amplitudes of echoes from successive sizes of FBH's at the same metal travel distance. For example: the signal from a #5 FBH is 4 dB larger than the signal from a #4 FBH, so the instrument gain would have to be decreased by 4 dB if a #4 FBH were available, but a #5 FBH was the required standard. If a #5 FBH were available, but a #2 FBH were required, the instrument gain would have to be increased 16 dB (7+5+4) for the inspection. A reference level (80%FSH) needs to be established for these equivalent transfers.

Table 5-4. Relative Signal Response from FBHs in ASTM Blocks

FBH Number (Size in 64ths of an inch)	Difference (dBs) From Previous FBH Size
2	
3	7
4	5
5	4
6	3
7	3
8	2

- b. Hole bottoms are checked for flatness, and hole orientation is checked for perpendicularity to the block surface.
- c. When FBH size is plotted versus respective ultrasonic echo amplitude for a given equipment setup, a straight line ± 2 dB SHOULD pass through the plotted points.

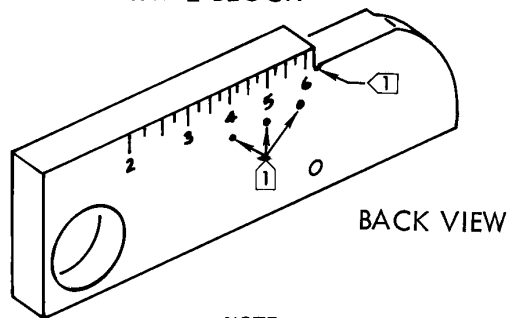
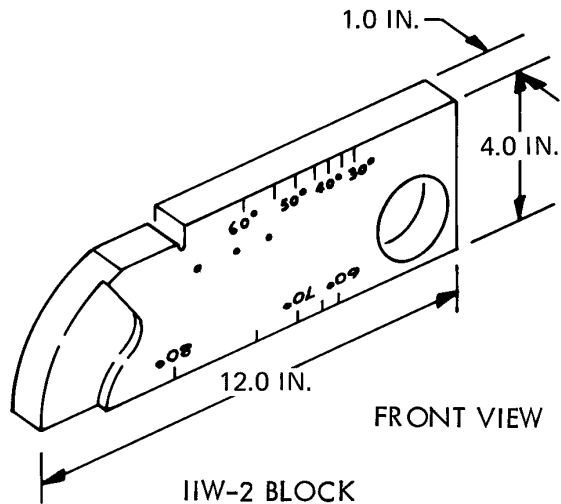
5.6.2.3 **Angle Beam Reference Standards.** There are two types of angle beam calibration blocks included in AS 455: the miniature angle beam block and the International Institute of Welding Type 2 IIW block ([Figure 5-82](#)). Either of these blocks MAY be used to perform the following tests for angle beam transducers:

- a. Check the refracted angle of the sound beam.

- b. Check the point-of-incidence of the refracted sound beam.
- c. Determine skew angle.

NOTE

Angle beam blocks made of aluminum and steel are standard; other materials MAY be specifically ordered.



NOTE
① THESE REFLECTORS MAY BE USED FOR SET UP OF SURFACE WAVE INSPECTIONS.

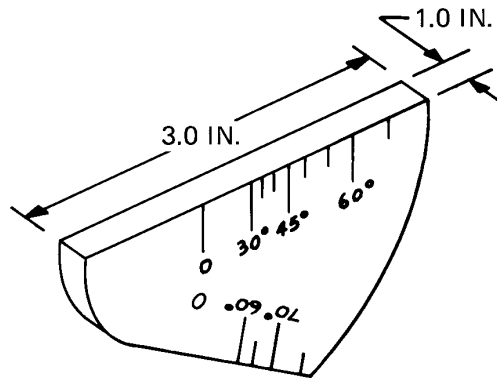


Figure 5-82. Angle Beam Block

5.6.2.4 Surface Wave Reference Standards. A variety of reflectors can be used to set up surface wave inspections. Electrical discharge machined notches, saw cuts, chiseled notches, and drilled holes can be used. Suggested surface wave standards are the side-drilled holes and the notch in the IIW block, when the transducer is placed on the large front, or back surface of the block. The reflected signal from one of the holes, or the notch, can be compared with the reflected signals from discontinuities in test parts. Signals **SHOULD** be compared at equivalent travel distances (distance from transducer to reference standard reflector, equal to distance from transducer to test part discontinuity).

5.6.3 System (Equipment) Checks. The most important system check is the calibration or standardization of each inspection setup through use of the applicable calibration or reference standards. An ultrasonic system consists of the instrument, search unit (transducer) and the coaxial cable. It is essential this calibration or standardization be accomplished before each and every inspection. Additionally, there are general calibration procedures that can be used to ensure the system is within the parameters required to perform ultrasonic inspections. The specific procedures, located in TO 33B-1-2 WP 105 00, **SHOULD** be performed, and documented, at the time intervals prescribed in applicable specifications or procedures, and whenever an operator suspects there is a problem with the equipment.

5.6.3.1 System Linearity.

5.6.3.1.1 Vertical Linearity.

5.6.3.1.1.1 Limits.

5.6.3.1.1.1.1 The upper linearity limit is the level of vertical deflection defining the upper limit of an observed constant relationship between the amplitude of the indications on an A-scan screen and the corresponding magnitude of the reflected ultrasonic wave from reflectors of known size.

5.6.3.1.1.1.2 The lower linearity limit is the level of vertical deflection defining the lower limit of an observed constant relationship between the amplitude of the indications on an A-scan screen and the corresponding magnitude of the reflected ultrasonic wave from reflectors of known size.

5.6.3.1.2 Horizontal Linearity.

5.6.3.1.2.1 Definitions.

5.6.3.1.2.1.1 The horizontal limit is the maximum readable length of horizontal deflection determined either by an electrical or physical limit in the A-scan presentation of an ultrasonic testing instrument. Horizontal limit is expressed as the maximum observed deflection in inches from the left side, or the start, of the horizontal line representing the time base.

5.6.3.1.2.1.2 The horizontal linearity range is the range of horizontal deflection in which a constant relationship exists between the incremental horizontal displacement of vertical indications on the A-scan presentation and the incremental time required for reflected waves to pass through a known length in a uniform transmission medium.

5.6.3.2 System Sensitivity. Sensitivity is a measure of the ability of the inspection system (e.g., instrument and transducer) to detect discontinuities producing relatively low-amplitude signals because of the size, geometry, or location of the discontinuities. Noise can limit the ability to detect discontinuities by masking their indications. Generally, sensitivity, resolution and signal-to-noise ratio are interdependent and **SHOULD** be evaluated under similar test conditions.

5.6.3.3 System Resolution. Resolution is the minimum spacing between discontinuities for which separate and distinct ultrasonic echo signals can be obtained. Spatial resolution refers to the lateral separation of discontinuities. Depth resolution, as the name implies, refers to depth separation between internal discontinuities or a discontinuity and a boundary surface. The following procedures are concerned only with entry and back surface resolutions, which are defined as the inspectable distances nearest to the respective surfaces of the test material. Resolution **SHALL** be checked when specified and **SHALL** meet the minimum requirements as given in [Table 5-5](#). This evaluation requires a reference standard with reference discontinuities at the respective distances from the appropriate surfaces of the standard.

NOTE

The 1 MHz and 15 MHz requirements are applicable only when these frequencies are used; they are not general requirements for all instruments.

Table 5-5. Limits of Boundary Surface Resolution

Frequency (MHz)	1	2.25	5	10	15
Entry Surface Resolution in Aluminum (inch)	0.5	0.375	0.25	0.125	0.125
Back Surface Resolution in Aluminum (inch)	0.5	0.3	0.2	0.1	0.1

5.6.4 Transducer Verifications.

NOTE

- Verification checks as written in this Technical Order may not be reproducible on some special purpose transducers mainly due to construction features of the transducer. Manufacturer’s guidelines SHALL be used for special purpose transducers that cannot be inspected with this technical order or TO 33B-1-2.
- ARMY ONLY: Special Purpose transducers that cannot be verified utilizing the process control checks outlined in this Technical Manual SHALL be evaluated by monitoring changes in signal-to-noise ratio during the inspection calibration process. For example, the UH-60 Black Hawk Spindle Lug Kit SHALL be monitored for signal-to-noise degradation by completing the inspection standardization IAW the latest procedure. Once the standardization has been completed, the inspector SHALL document the highest peak noise across the screen range WHILE the reference standard EDM notch is optimized. Signal-to-noise SHALL NOT exceed 3-1 (i.e. 80% FSH from EDM notch - Noise SHALL be less than 25% FSH).

5.6.4.1 Angle Beam Transducer Parameters. The angle of new and used ultrasonic transducers SHALL be maintained within 2-degrees of what is required to perform an ultrasonic inspection. Transducers that do not fall within this parameter SHALL NOT be used to perform ultrasonic inspections. If possible, transducers out of tolerance SHALL be reworked within parameters to extend their usefulness. The rework procedure consists of wet sanding the wear plate/wedge very slowly using 600-grit or finer sandpaper, or equivalent emery cloth. Extreme care SHALL be taken during sanding not to raise the temperature of the wear plate/wedge. Temperature increases will affect the acoustic impedance of the wear plate/wedge and therefore, the overall transducer sensitivity.

5.6.4.2 Angle Beam Checks. Calibration prior to angle beam inspection is typically accomplished with use of Type 2 IIW standard calibration block. Prior to accomplishing any angle beam calibrations, the beam point of incidence, refracted angle, and skew angle.

5.6.4.2.1 Point-of-Incidence.

NOTE

Due to a problem with the Type 2 IIW aluminum reference blocks, it SHALL NOT be used for determining the point-of-incidence on all shear wave transducers having a refracted angle greater than 45° (e.g., 60°, 70°, etc.). A steel Type 2 IIW block or the steel miniature block SHALL be used for testing Point-of-Incidence (POI) on all shear wave transducers over 45° intended for aluminum inspections. All other process control tests will be performed using the correct material reference block for the transducer used.

5.6.4.2.1.1 Angle Beam Point-of-Incidence (Type 2 IIW Block). The point-of-incidence is defined as the center point of the sound beam exiting the transducer wedge. It is usually indicated by a mark on the side of the wedge at the point where an imaginary line through the exit point of the beam intersects the side of the wedge. The procedure for determining the angle beam point-of-incidence is published in TO 33B-1-2, WP 105 00.

5.6.4.2.2 Angle Beam Misalignment (Skew Angle). Skew angle is a measure of the misalignment angle between the ultrasonic beam and the search units’ axis of symmetry. The procedure for determining the angle beam skew angle is published in TO 33B-1-2, WP 105 00.

5.6.4.2.3 **Transducer Angle Determination.** Angle beam transducers and wedges are labeled with their refracted angle in a given material. For example, a transducer labeled "45° AL", will produce a 45° refracted wave in aluminum. The angle determination is used to verify the refracted angle produced from the transducer/wedge is accurate. The procedures for determining the angle of a transducer is published in TO 33B-1-2 WP 105 00.

SECTION VII ULTRASONIC INSPECTION EQUATIONS

5.7 INTRODUCTION.

5.7.1 **General.** Understanding where your sound beam is located is very important in order to distinguish relevant discontinuities from non-relevant discontinuities.

5.7.2 **Snell's Law.** As covered in [Paragraph 5.2.4.1](#), when an incident longitudinal beam is normal to the test part surface ($\theta_1 = 0^\circ$), the longitudinal sound beam is transmitted straight into the test part and no refraction occurs. When the incident angle is other than normal, refraction, reflection, and mode conversion occur. Refraction is a change in propagation direction. Mode conversion is a change in the nature of the wave motion. A portion of the longitudinal incident beam is refracted into one or more wave modes traveling at various angles in the test piece ([Figure 5-6](#)). Wave behavior at an interface is defined by Snell's Law. The Snell's Law formula follows:

$$\frac{\sin \theta_1}{\sin \theta_2} = \frac{v_1}{v_2}$$

Where:

θ_1 = angle of incidence

θ_2 = angle of refracted beam

v_1 = velocity of incident sound beam

v_2 = velocity of refracted sound beam

5.7.3 **Determining the Angle of Incidence in Plastic to Generate 45-Degree Shear Wave in Aluminum.** As covered in [Paragraph 5.2.4.4](#), Snell's law is the tool for determining wedge angles for contact testing ([Paragraph 5.4.2.1.1.1](#)), or the angle-of-incidence in water for immersion testing ([Paragraph 5.4.2.1.1.2](#)). The following example shows how Snell's law is used to obtaining the required refracted beam and determine the angle-of-incidence in plastic to generate 45-degree shear waves in aluminum:

If:

$\theta_2 = 45^\circ$

v_1 = velocity of a longitudinal wave in plastic wedge = 1.05×10^5 in/sec (see [Table 5-6](#))

v_2 = velocity of shear waves in aluminum = 1.22×10^5 in/sec (see [Table 5-6](#))

$$\frac{\sin \theta_1}{\sin \theta_2} = \frac{v_1}{v_2} \text{ then, } \frac{\sin \theta_1}{.707} = \frac{1.05 \times 10^5}{1.22 \times 10^5} \text{ then, } \sin \theta_1 = \frac{(.707)(1.05 \times 10^5)}{1.22 \times 10^5} \text{ then, } \sin \theta_1 = 0.608$$

Therefore, $\theta_1 = 37.5^\circ$

5.7.4 **Wavelength.** The term "wavelength" is the distance a wave travels while going through one cycle. As a rule of thumb, the smallest detectable flaw is equal to half the wavelength. Wavelength is defined by the formula:

$$\lambda \text{ (lambda)} = v/f$$

Where:

λ = wavelength (normally inches or centimeters)

v = velocity (inches or centimeters per second)

f = frequency (hertz)

Example: Calculate the wavelength for a 2.25 MHz longitudinal transducer in aluminum if the velocity is 2.46×10^5 in/sec.

$$\lambda = v/f$$

$$\lambda = (2.46 \times 10^5) / (2.25 \times 10^6)$$

$$\lambda = 0.109 \text{ inch}$$

To calculate the smallest detectable flaw, divide by 2:

$$0.109/2 = 0.055 \text{ inch}$$

5.7.5 Near Field. The near field ([Paragraph 5.2.6.2](#)) extends from the face of the transducer and is an area characterized by wide variations in sound beam intensity. These intensity variations are due to the interference effects of spherical wave fronts (side lobes) emanating from the periphery of the transducer crystal. The region where this side lobe interference occurs is called the near field (Fresnel Zone) ([Figure 5-9](#)). Due to inherent amplitude variations, inspection within the near field is not typically recommended. The length of the near field is calculated with the following equation:

$$N = \frac{D^2}{4\lambda} = \frac{f D^2}{4v}$$

Where:

N = near field length (inches)

D = diameter of transducer element in a round transducer or maximum diagonal of transducer element in a rectangular or square transducer (inches)

λ = wavelength of sound in the test material (inches)

f = frequency (Hz)

v = velocity (in/sec)

Example:

If the diameter of a 5 MHz transducer is .5 inches and aluminum 1100-0 is under inspection:

$$N = \frac{D^2}{4\lambda} \text{ then, } N = \frac{(.5)^2}{(4)(.050)} \text{ then, } N = \frac{.25}{.200} \text{ then, } N = 1.25 \text{ inches}$$

5.7.5.1 The smaller the transducer element diameter or the lower the frequency, the shorter the near field will be. Due to inherent amplitude variations, inspection within the near field is not recommended without careful calibration on reference flaws within the near field.

5.7.6 Beam Spread. As covered in [Paragraph 5.2.6.5](#), the sound beam in the near field, essentially propagates straight out from the face of the transducer. In the far field, the sound beam spreads outward and decreases in intensity with increasing distance from the transducer face as shown in [Figure 5-10](#). Beam spread is an important consideration, because in certain inspection applications the spreading sound beam could result in erroneous or confusing A-scan presentations. The half-angle of the beam spread is calculated as follows:

$$\sin \theta = \frac{1.22 \lambda}{D} \quad \text{or} \quad \sin \theta = \frac{1.22 V}{f D}$$

Where:

θ = half-angle of spread

D = transducer diameter (inches)

λ = wavelength (inches)

f = frequency (Hz)

v = velocity (in/sec)

Example: Given 2014-T4 aluminum being tested with a 1/4-inch diameter search unit at 5 MHz longitudinal wave, what is the half angle of the beam spread?

D = 1/4 inch (0.25 inch)

λ = 0.049 inch

$$\sin \theta = \frac{1.22 \lambda}{D} \quad \text{then,} \quad \sin \theta = \frac{(1.22)(0.049)}{.25} \quad \text{then,} \quad \sin \theta = 0.2391 \quad \text{then} \quad \theta = 14^\circ$$

Remember this is the half angle value; to get the full angle of the beam spread it is necessary to double the achieved value of the angle θ .

As denoted by the beam spread formula at a given frequency, the smaller the transducer element, the greater the beam spread. Also, for a given diameter, a lower frequency results in more beam spread.

5.7.7 Calculating Acoustic Impedance. As covered in [Paragraph 5.5.4.3](#), the reflections from an air interface, such as a crack or void are large due to the acoustic impedance ratio. If a discontinuity had acoustic impedance close to the acoustic impedance of the test material, the acoustic impedance ratio would be small and very little reflection would occur. When an ultrasonic beam strikes a boundary between two different materials, part of the energy is transmitted to the second medium and a portion is reflected. The percentage of sound energy transmitted and reflected is related to the ratio of the acoustic impedances of the two materials. Acoustic impedance can be calculated as follows:

$$Z = \rho v$$

Where:

Z = acoustic impedance of a material (lb/in²-sec)

ρ (rho) = material density (lb/in³)

v = velocity of sound in the material (in/sec)

If the material density of aluminum 2014 is 0.1012 and velocity is 2.46×10^5

$$Z = \rho v \quad \text{then,} \quad Z = (0.1012)(246000) \quad \text{then,} \quad Z = 24895 \text{ lb/in}^2 \text{ - sec}$$

5.7.7.1 Determining Reflected Energy at the Interface. Acoustic impedance can be used to calculate the theoretical reflected and transmitted energy for an interface. The following formula is used to determine the amount of reflected energy that occurs at an interface.

$$R = \left(\frac{Z_2 - Z_1}{Z_2 + Z_1} \right)^2 \times 100$$

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Where:

R = percentage of energy reflected at the interface.

Z_2 = acoustic impedance of the discontinuity (lb/in²-sec)

Z_1 = acoustic impedance of the test material (lb/in²-sec)

Example: A tungsten inclusion is found in a piece of titanium. How much energy will be reflected at the interface if 100-percent of the sound energy strikes the tungsten?

Known from:

Acoustic impedance of tungsten (Z_2) = 14.20 (10⁴ (lb/in²-sec))

Acoustic impedance of titanium (Z_1) = 3.94 (10⁴ (lb/in²-sec))

Solution:

$$R = \left(\frac{14.20 - 3.94}{14.20 + 3.94} \right)^2 \times 100 = \left(\frac{10.26}{18.14} \right)^2 \times 100 = (0.5656)^2 \times 100 = 0.32 \times 100 = 32\%$$

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Therefore, 32-percent of the energy will be reflected at the interface by the tungsten inclusion. The remaining 68 percent (T% = 100 - R% = 100 - 32) of the energy is transmitted through the tungsten inclusion. A crack would reflect virtually 100-percent of the energy because it is filled with air.

5.7.8 Thickness Measurement Correlation Factor. As we covered in [Paragraph 5.4.11.3](#), prior to performing thickness measurement, consult the instruments operator's manual to see if one or two reference standards are required. If two are required, it is best to have one 50-90-percent of the nominal thickness to be measured, and one 110-150-percent of the nominal thickness to be measured. Only one reference standard is required when using a basic pulsed instrument for thickness measurement. Direct, accurate readings of thickness can be obtained only when the acoustic velocity in the reference standard is equal to the acoustic velocity in the test part. For this reason, the material and heat treat condition of the reference standard SHOULD be identical to the test part. If reference standards, of a different material, or heat treat condition is used; the resultant thickness readings SHALL be corrected by a correlation factor. The correlation factor MAY be established in two ways:

- a. Use the ratio V_2/V_1 when the velocities of the test part and reference standard are known.

Where:

v_2 = acoustic velocity in the test part material

v_1 = acoustic velocity in the reference standard material

Example: Assume the calibration blocks are made of 2014-T4 aluminum and the test part material is 410 stainless steel.

v_2 = longitudinal wave velocity in 410 stainless steel = 2.91 x 10⁵ inches/sec.

v_1 = longitudinal wave velocity in 2014-T4 aluminum = 2.46 x 10⁵ inches/sec.

$$\frac{V_2}{V_1} = \frac{2.91 \times 10^5}{2.46 \times 10^5} = 1.18 = \text{The Correlation Factor}$$

All readings on the test part are now multiplied by 1.18 to obtain the actual thickness. If a test part reading is 0.110-inch, correct this by multiplying by the correlation factor:

0.110-inch x 1.18 = 0.130-inch = the actual test part thickness

- b. Use this ratio when one area of the test part is accessible for direct measurement.

Use the ratio $\frac{d_2}{d_1}$ when one area of the test part is accessible for direct measurement.

Where:

d_2 = the thickness of an area of the test part as measured by mechanical or optical means (inch)

d_1 = the thickness of the same area as indicated by the ultrasonic instrument calibrated on material similar to the test part (inch)

Example: Assume an area of a test part is measured with a micrometer and is 0.167-inch thick ($d_2 = 0.167$ -inch). This same area is measured with ultrasonic instrument and gives a reading of 0.133-inch ($d_1 = 0.133$ -inch).

$$\frac{d_2}{d_1} = \frac{0.167}{0.133} = 1.25 = \text{the correlation factor}$$

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All ultrasonic readings on the test part are now multiplied by 1.25 to obtain the actual thickness. If another area of the test part gives an ultrasonic reading of 0.200-inch, correct this by multiplying by the correlation factor:

0.200-inch x 1.25 = 0.250-inch = the actual test part thickness.

SECTION VIII ULTRASONIC INSPECTION SAFETY

5.8 INTRODUCTION.

5.8.1 **Safety Requirements.** Safety requirements SHALL be reviewed by the laboratory supervisor on a continuing basis to ensure compliance with provisions contained in AFMAN 91-203, as well as, provisions of this technical order and applicable weapons systems technical orders. Recommendations of the Base Bioenvironmental Engineer and the manufacturer regarding necessary personnel protective equipment SHALL be followed.

NOTE

AFMAN 91-203 or appropriate service directive shall be consulted for additional safety requirements.

5.8.2 **General Precautions.** Precautions to be exercised when performing ultrasonic inspection include consideration of exposure to electrical current. The following minimum safety requirements SHALL be observed when performing ultrasonic inspections.

5.8.2.1 Ultrasonic Inspection. Ultrasonic equipment can safely be used in and around aircraft provided the following electrical safety guidelines are followed.

5.8.2.2 Most ultrasonic units can operate safely in the Class I, Division 2 environment identified in NFPA 70, National Electrical Code. Conformance, when necessary, should be verified by either manufactures' statement or passing testing in accordance with MIL-STD-810. Transducer or battery changes and recharging shall be performed outside this environment.

5.8.2.3 Most ultrasonic instruments are NOT rated as "explosion proof" and not rated for use in the Class I, Division 1 environment.

5.8.2.4 Batteries, power cord, and charger/adaptor are provided with most ultrasonic instruments. Ensure the correct batteries, charger/adaptor, and power cord are used to avoid damage to instruments or serious injury to the user.

Table 5-6. Ultrasonic Properties of Materials

Material	Velocity (10 ⁵ inches/sec)		Wave Length (inches)												Acoustic impedance (10 ⁴ lb/in ² - sec)	
			Longitudinal Waves			Shear Waves			Surface Waves							
	Longitudinal Waves	Shear Waves	Surface Waves	Longitudinal Waves (MHz)			Shear Waves (MHz)			Surface Waves (MHz)						
				1	2.25	5	10	1	2.25	5	10	1	2.25	5		10
METALS:																
Aluminum 1100 - 0	2.50	1.22	1.14	0.250	0.111	0.050	0.025	0.122	0.054	0.024	0.012	0.114	0.051	0.023	0.011	2.45
Aluminum 2014 - T4	2.46	1.22	1.10	0.246	0.109	0.049	0.025	0.122	0.054	0.024	0.012	0.110	0.049	0.022	0.011	2.49
Beryllium	5.02	3.43	3.10	0.502	0.224	0.101	0.050	0.343	0.152	0.069	0.034	0.310	0.138	0.062	0.031	3.32
Brass, Naval	1.75	0.83	0.77	0.175	0.078	0.035	0.017	0.083	0.037	0.017	0.008	0.077	0.034	0.015	0.008	5.13
Bronze, Phosphor, 5%	1.39	0.88	0.79	0.139	0.062	0.028	0.014	0.088	0.039	0.018	0.009	0.079	0.035	0.016	0.008	4.44
Copper	1.84	0.89	0.76	0.184	0.081	0.037	0.018	0.089	0.040	0.018	0.009	0.076	0.034	0.015	0.008	5.96
Lead, Pure	0.85	0.28	0.25	0.085	0.038	0.017	0.009	0.028	0.012	0.006	0.003	0.025	0.011	0.005	0.003	3.50
Lead, Antimony, 6%	0.85	0.32	0.29	0.085	0.038	0.017	0.009	0.032	0.014	0.006	0.003	0.029	0.013	0.006	0.003	3.36
Molybdenum	2.48	1.32	1.22	0.248	0.110	0.050	0.025	0.132	0.059	0.026	0.013	0.122	0.054	0.024	0.012	9.04
Nickel	2.22	1.17	1.04	0.222	0.099	0.044	0.022	0.177	0.052	0.023	0.012	0.104	0.046	0.021	0.010	7.05
Inconel, Wrought	3.08	1.19	1.10	0.308	0.136	0.062	0.031	0.119	0.053	0.024	0.012	0.110	0.049	0.022	0.011	9.18
Monel, Wrought	2.38	0.97	0.77	0.238	0.106	0.048	0.024	0.107	0.048	0.021	0.011	0.077	0.034	0.015	0.008	7.56
Silver - 18Ni	1.82	0.91	0.66	0.182	0.080	0.036	0.018	0.091	0.040	0.018	0.009	0.066	0.029	0.013	0.007	5.74
Iron	2.32	1.27	1.10	0.232	0.103	0.046	0.023	0.127	0.056	0.025	0.013	0.110	0.049	0.022	0.011	6.45
Iron, Cast	1.89	0.95		0.189	0.084	0.039	0.019	0.095	0.042	0.019	0.010					5.30
Steel, 302	2.24	1.23	1.23	0.223	0.099	0.045	0.022	0.123	0.055	0.025	0.012	0.123	0.055	0.025	0.012	6.35
Steel, 347	2.26	1.22		0.226	0.100	0.045	0.023	0.122	0.054	0.024	0.012					6.35
Steel, 410	2.91	1.18	0.85	0.291	0.129	0.058	0.029	0.118	0.052	0.024	0.012	0.085	0.038	0.017	0.009	8.05
Steel 1020	2.32	1.28		0.232	0.103	0.046	0.023	0.128	0.057	0.026	0.013					6.45
Steel 1095	2.32	1.26		0.232	0.103	0.046	0.023	0.126	0.056	0.025	0.013					6.53
Steel, 4150, Rc 14	2.31	1.10		0.231	0.103	0.046	0.023	0.110	0.049	0.022	0.011					6.52
Steel, 4150, Rc 18	2.31	1.25		0.231	0.103	0.046	0.023	0.125	0.056	0.025	0.012					6.53
Steel, 4150, Rc 43	2.31	1.26		0.231	0.103	0.046	0.023	0.126	0.056	0.025	0.013					6.51
Steel, 4150, Rc 64	2.30	1.09		0.230	0.102	0.046	0.023	0.109	0.048	0.022	0.011					6.46
Steel, 4340	2.30	1.26		0.230	0.102	0.046	0.023	0.126	0.056	0.025	0.013					7.24

Table 5-6. Ultrasonic Properties of Materials - Continued

Material	Velocity (10 ⁵ inches/sec)		Wave Length (inches)										Acoustic impedance (10 ⁴ lb/in ² - sec)			
	Longitudinal Waves	Shear Waves	Surface Waves	Longitudinal Waves (MHz)			Shear Waves (MHz)			Surface Waves (MHz)						
				1	2.25	5	10	1	2.25	5	10	1		2.25	5	10
Titanium, 150 A	2.40	1.23	1.10	0.240	0.107	0.048	0.024	0.123	0.055	0.025	0.012	0.110	0.049	0.022	0.011	3.94
Tungsten	2.04	1.13	1.04	0.204	0.091	0.041	0.020	0.113	0.050	0.023	0.011	0.104	0.046	0.021	0.010	14.20
NON-METALS:																
Air	0.13			0.013	0.006	0.003	0.001									0.00047
Water	0.59			0.059	0.026	0.012	0.006									0.212
Motor Oil, SAE20	0.68			0.068	0.030	0.014	0.007									0.214
Transformer Oil	0.54			0.054	0.024	0.011	0.005									0.181
Bakelite	1.02			0.102	0.045	0.020	0.010									0.515
Lucite	1.06	0.50		0.106	0.047	0.021	0.011	0.050	0.022	0.010	0.005			0.005		0.448
Plastic, Acrylic Resin	1.05	0.44		0.105	0.047	0.021	0.011	0.044	0.020	0.009	0.004					0.455
Plexiglass	1.09			0.109	0.048	0.022	0.011									0.494
Teflon	0.57			0.057	0.025	0.011	0.006									0.426
Quartz, Natural	2.26			0.226	0.100	0.045	0.023									2.16
Fused Quartz	2.33	1.48	1.33	0.233	0.104	0.047	0.023	0.148	0.066	0.030	0.015	0.133	0.059	0.027	0.013	1.85
Pyrex	2.20	1.35	1.23	0.220	0.098	0.044	0.022	0.135	0.060	0.027	0.014	0.123	0.055	0.025	0.012	1.77
Plate Glass	2.28	1.35	1.24	0.228	0.101	0.046	0.023	0.135	0.060	0.027	0.014	0.124	0.055	0.025	0.012	2.06

Table 5-7. Measurement Error Introduced by Surface Roughness of Reference Standard or Test Part

Surface Finish (microinches)	Measurement Error (inch)
0 - 63	0.0005
63 - 125	0.002
125 - 250	0.005
250 - 500	0.010
500 - 20000	0.020

Table 5-8. Incident Longitudinal Wave Angle in Plastic (degrees)

Refracted Shear Wave Angle in Test Materials (Degrees)	Steel	Stainless Steel 302	Stainless Steel 410	Ti 150A	A1 1100-0	AL 2014-T4	Inconel Wrought	Magnesium AM 35
20	16.4	17	17.8	17	17.1	17.1	17.6	17.1
21	17.2	17.9	18.7	17.9	18	18	18.5	18
22	18	18.7	19.5	18.7	18.8	18.8	19.3	18.8
23	18.8	19.5	20.4	19.5	19.7	19.7	20.2	19.7
24	19.6	20.4	21.3	20.4	20.5	20.5	21.1	20.5
25	20.4	21.2	22.2	21.2	21.3	21.3	21.9	21.3
26	21.2	22	23	22	22.2	22.2	22.8	22.2
27	22	22.9	23.9	22.9	23	23	23.7	23
28	22.8	23.7	24.8	23.7	23.9	23.9	24.5	23.9
29	23.6	24.5	25.7	24.5	24.7	24.7	25.4	24.7
30	24.4	25.3	26.5	25.3	25.5	25.5	26.2	25.5
31	25.2	26.2	27.4	26.2	26.3	26.3	27.1	26.3
32	26	27	28.2	27	27.2	27.2	27.9	27.2
33	26.8	27.8	29.1	27.8	28	28	28.8	28
34	27.5	28.6	30	28.5	28.8	28.8	29.6	28.8
35	28.3	29.4	30.8	29.4	29.6	29.6	30.5	29.6
36	29.1	30.2	31.7	30.2	30.4	30.4	31.3	30.4
37	29.8	31	32.5	31	31.2	31.2	32.1	31.2
38	30.6	31.8	33.4	31.8	32	32	33	32
39	21.3	32.5	34.2	32.6	32.8	32.8	33.8	32.8
40	32.1	33.4	35	33.4	33.6	33.6	34.6	33.6
41	32.8	34.2	35.9	34.2	34.4	34.4	35.5	34.4
42	33.6	34.9	36.7	34.9	35.2	35.2	36.3	35.2
43	34.3	35.7	37.5	35.7	36	36	37.1	36
44	35	36.5	38.3	36.5	36.7	36.7	37.9	36.7
45	35.8	37.2	39.2	37.2	37.5	37.5	38.7	37.5
46	36.5	38	40	38	38.3	38.3	39.5	38.3
47	37.2	38.7	40.8	38.7	39	39	40.3	39
48	37.9	39.5	41.4	39.5	39.8	39.8	41.1	39.8
49	38.5	40.2	42.4	40.2	40.5	40.5	41.9	40.5
50	39.3	41	43.2	41	41.3	41.3	42.6	41.3
51	40	41.7	43.9	41.7	42	42	43.4	42
52	40.6	42.4	44.7	42.4	42.7	42.7	44.2	42.7
53	41.3	43.1	45.5	43.1	43.5	43.5	44.9	43.5

Table 5-8. Incident Longitudinal Wave Angle in Plastic (degrees) - Continued

Refracted Shear Wave Angle in Test Materials (Degrees)	Steel	Stainless Steel 302	Stainless Steel 410	Ti 150A	A1 1100-0	AL 2014-T4	Inconel Wrought	Magnesium AM 35
54	42	43.8	46.3	43.8	44.2	44.2	45.7	44.2
55	42.6	44.5	47	44.5	44.9	44.9	46.4	44.9
56	43.3	45.2	47.8	45.2	45.6	45.6	47.1	45.6
57	43.9	45.9	48.5	45.9	46.2	46.2	47.9	46.2
58	44.5	46.5	49.2	46.5	46.9	46.9	48.5	46.9
59	45.1	47.2	49.9	47.2	47.6	47.6	49.3	47.5
60	45.7	47.4	50.4	47.7	48.2	48.2	49.8	48.2
61	46.3	48.5	51.4	48.5	48.9	48.9	50.6	48.9

CHAPTER 6 RADIOGRAPHIC INSPECTION METHOD

SECTION I RADIOGRAPHIC (RT) INSPECTION METHOD

6.1 GENERAL CAPABILITIES OF RADIOGRAPHIC INSPECTION.

6.1.1 Introduction to Radiographic Inspection. This chapter will provide guidance for radiographic inspection. Additional helpful material is cited in the form of references, primarily books and standards. References are listed at the end of this chapter.

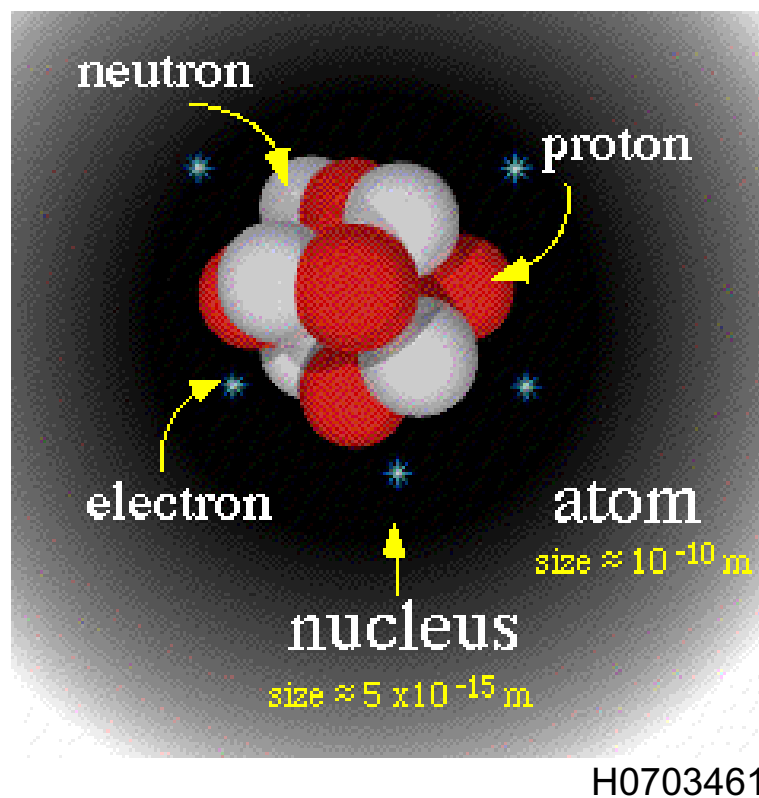


Figure 6-1. Nuclear Structure

6.1.1.1 Nuclear Structure. An atom consists of an extremely small, positively charged nucleus surrounded by a cloud of negatively charged electrons. Although typically the nucleus is less than one ten-thousandth the size of the atom, the nucleus contains more than 99.9% of the mass of the atom. Nuclei consist of positively charged protons and electrically neutral neutrons held together by the so-called strong or nuclear force. This force is much stronger than the familiar electrostatic force that binds the electrons to the nucleus, but its range is limited to distances approximately a few $\times 10^{-15}$ meters. Refer to [Figure 6-1](#).

6.1.1.1.1 The number of protons in the nucleus, "Z" is called the atomic number. This determines what chemical element the atom is. "N" denotes the number of neutrons in the nucleus. The atomic mass of the nucleus, "A" is equal to $Z + N$. A given element can have many different isotopes, which differ from one another by the number of neutrons contained in the nuclei. In a neutral atom, the number of electrons orbiting the nucleus equals the number of protons in the nucleus. Since the

electric charges of the proton and the electron are +1 and -1 respectively (in units of the proton charge), the net charge of the atom is zero. At present, there are 118 known elements which range from the lightest, hydrogen, to the recently named element 118, Ununoctium. All of the elements heavier than uranium are manmade. Among the elements are approximately 270 stable isotopes, and more than 2000 unstable isotopes.

6.1.2 History of X- and Gamma Radiation. X-rays were discovered by chance in 1895 by W.C. Roentgen. He noticed a screen painted in barium platinocyanide fluoresced when placed in close proximity to a cathode-ray tube. He called these X-rays, because their nature was unknown. In 1912, M. von Laue and other investigators identified X-rays as electromagnetic waves similar in nature to visible light; however, X-rays are invisible and they have far greater penetrating power than light.

6.1.2.1 Radium emits alpha and beta particles and gamma rays, which are penetrating in the same manner as X-rays. In 1898, Marie Curie termed the emanations of this element radioactivity. Besides radium, many radioactive elements have since been discovered. At present, not only the rays emitted by such radioactive sources, but beams emitted in nuclear reactions are also derived from radioactivity. Of these radioactive sources, X- and gamma radiation are widely used in industrial radiography. X-radiation has a continuously heterogeneous energy spectrum, while gamma radiation has a discrete spectrum characteristic to the particular radioactive element involved. Other important discoveries in the history of radiation are explored in [Table 6-1](#).

Table 6-1. History of X- and Gamma Radiation

Year	Scientist(s)	Discovery
1704	<u>Isaac Newton</u>	Proposed a mechanical universe with small solid masses in motion.
1803	<u>John Dalton</u>	Proposed an “atomic theory” with spherical solid atoms based upon measurable properties of mass.
1832	<u>Michael Faraday</u>	Studied the effect of electricity on solutions, coined term “electrolysis” as a splitting of molecules with electricity, developed laws of electrolysis. Faraday himself was not a proponent of atomism.
1859	J. Plucker	Built one of the first gas discharge tubes (“cathode ray tube”).
1869	<u>Dmitri Mendeleev</u>	Arranged elements into 7 groups with similar properties. He discovered that the properties of elements were periodic functions of their atomic weights. This became known as the Periodic Law.
1873	<u>James Clerk Maxwell</u>	Proposed electric and magnetic fields filled the void.
1874	<u>G.J. Stoney</u>	Proposed that electricity was made of discrete negative particles he called electrons.
1879	<u>Sir William Crookes</u>	Discovered cathode rays had the following properties: travel in straight lines from the cathode; cause glass to fluoresce; impart a negative charge to objects they strike; are deflected by electric fields and magnets to suggest a negative charge; cause pin-wheels in their path to spin indicating they have mass.
1886	E. Goldstein	Used a CRT to study “canal rays” which had electrical and magnetic properties opposite of an electron.
1895	<u>Wilhelm Roentgen</u>	Using a CRT, he observed that nearby chemicals glowed. Further experiments found very penetrating rays coming from the CRT that were not deflected by a magnetic field. He named them “X-rays.”
1896	<u>Henri Becquerel</u>	While studying the effect of X-rays on photographic film, he discovered some chemicals spontaneously decompose and give off very penetrating rays.
1897	<u>J.J. Thomson</u>	Used a CRT to experimentally determine the charge to mass ratio (e/m) of an electron = 1.759×10^8 coulombs/gram.
1897	<u>J.J. Thomson</u>	Studied “canal rays” and found they were associated with the proton H^+ .
1898	<u>Rutherford</u>	Studied radiations emitted from uranium and thorium and named them <i>alpha</i> and <i>beta</i> .
1898	<u>Marie Sklodowska Curie</u>	Studied uranium and thorium and called their spontaneous decay process “radioactivity.” She and her husband Pierre also discovered the radioactive elements polonium and radium.

Table 6-1. History of X- and Gamma Radiation - Continued

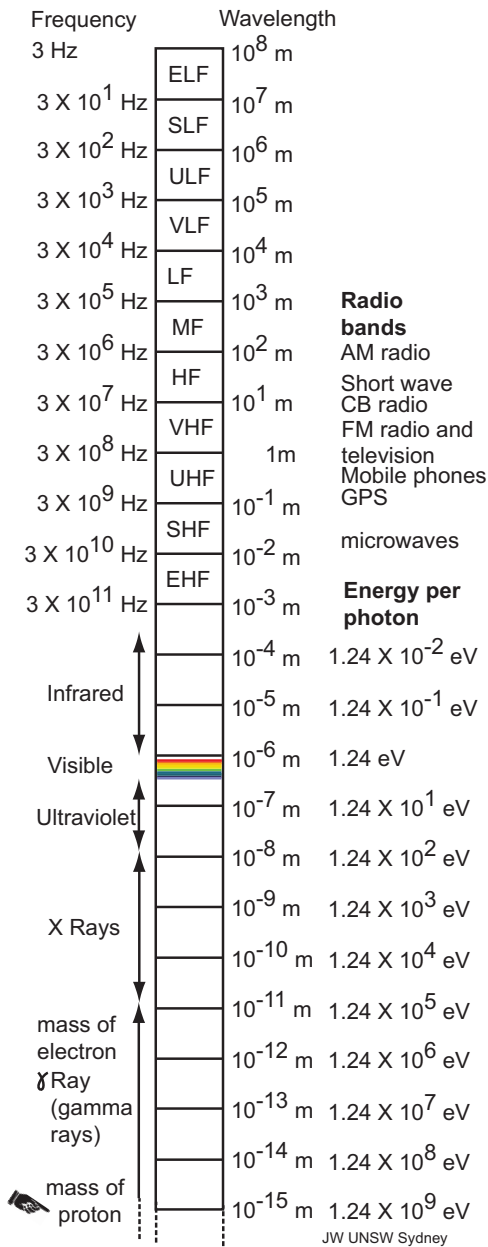
Year	Scientist(s)	Discovery
1900	<u>Soddy</u>	Observed spontaneous disintegration of radioactive elements into variants he called "isotopes" or totally new elements, discovered "half-life," made initial calculations on energy released during decay.
1900	<u>Max Planck</u>	Used the idea of quanta (discrete units of energy) to explain hot glowing matter.
1903	<u>Nagaoka</u>	Postulated a "Saturnian" model of the atom with flat rings of electrons revolving around a positively charged particle.
1904	Abegg	Discovered that inert gases had a stable electron configuration which lead to their chemical inactivity.
1906	<u>Hans Geiger</u>	Developed an electrical device to "click" when hit with alpha particles.
1909	<u>R.A. Millikan</u>	Oil drop experiment determined the charge ($e=1.602 \times 10^{-19}$ coulomb) and the mass ($m = 9.11 \times 10^{-28}$ gram) of an electron.
1911	<u>Ernest Rutherford</u>	Using alpha particles as atomic bullets, probed the atoms in a piece of thin (0.00006 cm) <u>gold foil</u> . He established that the nucleus was very dense, very small and positively charged. He also assumed that the electrons were located outside the nucleus.
1914	<u>H.G.J. Moseley</u>	Using X-ray tubes, determined the charges on the nuclei of most atoms. He wrote, "The atomic number of an element is equal to the number of protons in the nucleus." This work was used to reorganize the periodic table based upon atomic number instead of atomic mass.
1919	Aston	Discovered the existence of isotopes using a mass spectrograph.
1922	<u>Niels Bohr</u>	Developed an explanation of atomic structure that underlies regularities of the periodic table of elements. His atomic model had atoms built up of successive orbital shells of electrons.
1923	<u>de Broglie</u>	Discovered that electrons had a dual nature-similar to both particles and waves. Particle/wave duality. Supported Einstein.
1927	<u>Heisenberg</u>	Described atoms by means of formula connected to the frequencies of spectral lines. Proposed Principle of Indeterminacy - you cannot know both the position and velocity of a particle.
1929	<u>Cockcroft/Walton</u>	Built an early linear accelerator and bombarded lithium with protons to produce <i>alpha particles</i> .
1930	<u>Schrodinger</u>	Viewed electrons as continuous clouds and introduced "wave mechanics" as a mathematical model of the atom.
1930	<u>Paul Dirac</u>	Proposed <i>anti-particles</i> . Anderson discovered the anti-electron (positron) in 1932 and Segre/Chamberlain detected the anti-proton in 1955.
1932	<u>James Chadwick</u>	Using alpha particles discovered a neutral atomic particle with a mass close to a proton. Thus was discovered the neutron.
1938	<u>Lise Meitner, Hahn, Strassman</u>	Conducted experiments verifying that heavy elements capture neutrons and form unstable products which undergo fission. This process ejects more neutrons continuing the fission chain reaction.
1941 - 1951	<u>Glenn Seaborg</u>	Synthesized 6 transuranium elements and suggested a change in the layout of the periodic table.
1942	<u>Enrico Fermi</u>	Conducted the first controlled chain reaction releasing energy from the atom's nucleus.

6.1.3 Factors of Radiographic Inspection. X- and gamma radiographic inspection uses the penetrating abilities of electromagnetic radiation to examine the interior of objects. Three prime factors determine the amount of information radiography can provide about an object: 1) The composition of the object, 2) The density of the material making up the object, 3) The energy of the X- or gamma rays incident upon the object. Discontinuities within the object can cause localized changes in the first two characteristics above and thus, become detectable.

6.1.4 The Physics of X-rays. X-rays are high-energy photons that are produced when electrons make transitions from one atomic orbit to another. These transitions can be generated via the photoelectric effect as illustrated in [Figure 6-13](#). If you

send a photon into an atom with an energy greater than the binding energy of an electron in that atom, the photon can knock that electron out of its orbit, leaving a hole (or vacancy). This hole can then be filled by another electron in the atom, giving off an X-ray in the transition to conserve energy. This process is known as fluorescence. Many different atomic electrons of different binding energies can fill this hole, so you would expect to see many energy peaks in an X-ray spectrum.

6.1.4.1 The Nature of Radiation. All together, X-rays and gamma rays, visible light, ultraviolet light, infrared radiation, microwaves, and radio waves make up the electromagnetic spectrum ([Figure 6-2](#)). Electromagnetic radiation is dualistic; meaning it exhibits some characteristics of a wave and some characteristics of a particle. In this case, the particle is called a photon, which is a quantum of light. Depending upon the application, X-rays might exhibit a more wave-like behavior or more quantum-like behavior.



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Figure 6-2. Wavelength

WARNING

Exposure to excessive X- or gamma radiation is harmful to human beings. While most X-ray equipment is designed to minimize the danger of exposure to direct or stray radiation, certain precautions SHALL be observed. Radiation protection requirements are discussed in [Paragraph 6.8](#) of this chapter.

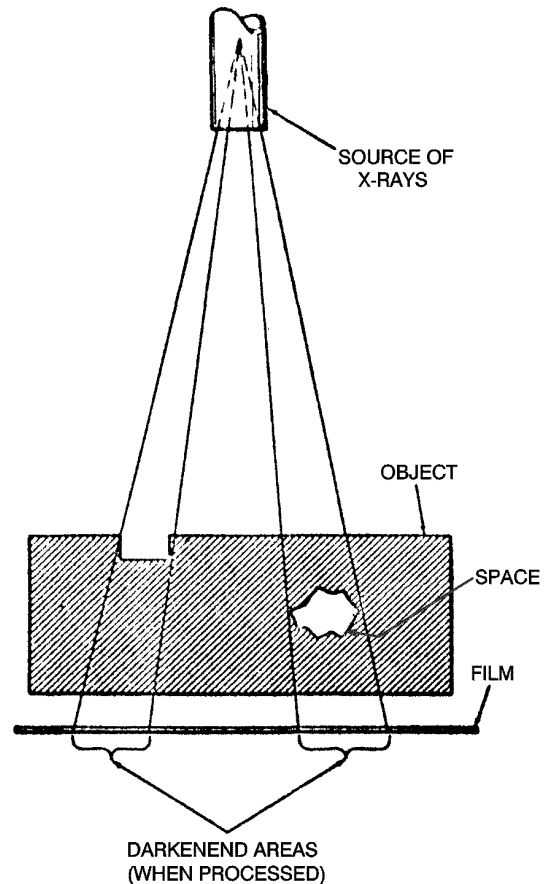
6.1.4.2 The most distinguishing characteristic of X-rays is their short wavelength. The penetrating ability of X-rays is directly proportional to their energy, which in turn, is inversely proportional to their wavelength; that is, the shorter the wavelength, the higher the energy; the longer the wavelength, the lower the energy. Short wavelength X-rays are commonly described as “hard” while long wavelength X-rays are referred to as “soft.”

6.1.5 Properties of X- and Gamma Radiation. There are several properties which X-rays and gamma rays possess making them useful for radiographic inspection. X-rays and gamma rays are the same form of energy as visible light; both are part of the electromagnetic spectrum. Like light, both are refracted when they pass through glass, such as a lens, or any other medium; however, the amount of refraction of X- or gamma rays using visible-light optics is so slight as to be unnoticeable. Although the properties of X- and gamma rays and visible light are theoretically similar, the differences in application make it most convenient to consider X- and gamma rays as being different, since their observable effects are quite different from those of light. This is noted particularly in the ability to penetrate matter. Some general properties of X- and gamma rays may be summarized as follows:

- They are invisible to humans.
- They propagate in straight lines in free space.
- In special cases they are reflected, diffracted, refracted, and polarized as light, but to a much smaller degree.
- They propagate at a velocity of 3×10^8 meters per second as does light.
- They consist of transverse electromagnetic vibrations as does light.
- X-rays have energies between roughly 1 kilo electron volt (keV) and 50 MeV.
- X-rays for NDI are produced by the interaction of high-energy electrons or ions with matter.
- Gamma rays are produced in nuclear transformations, such as radioactive decay.
- X-rays and gamma rays expose (darken) photographic film.
- They stimulate fluorescence and phosphorescence in some materials.
- They are capable of ionizing gases and changing the electrical properties of some liquids and solids.
- They are able to damage and kill living cells and to produce genetic mutations.
- They are differentially absorbed or scattered by different media.
- X-rays may be diffracted by the crystalline structure of materials, which acts like a grating.
- They do not affect fuel cells or munitions.

6.1.5.1 All of these properties contribute in some degree to the understanding of the radiographic process. Most important of these in terms of usefulness to NDI are the differential absorption of radiation in matter and the ability of radiation to expose film. In the remainder of this chapter the term “X-rays” will be more prevalent since that form of radiation is most used. Except where noted the discussion will also apply to gamma rays.

6.1.6 **Differential Absorption of Radiation in Matter.** A material discontinuity, such as a void or change in configuration (Figure 6-3), changes the effective thickness of a material, and thus changes the degree of radiation absorption. Since all radiation not absorbed or scattered within a material is transmitted, the amount of transmitted radiation varies with localized changes in effective material thickness.



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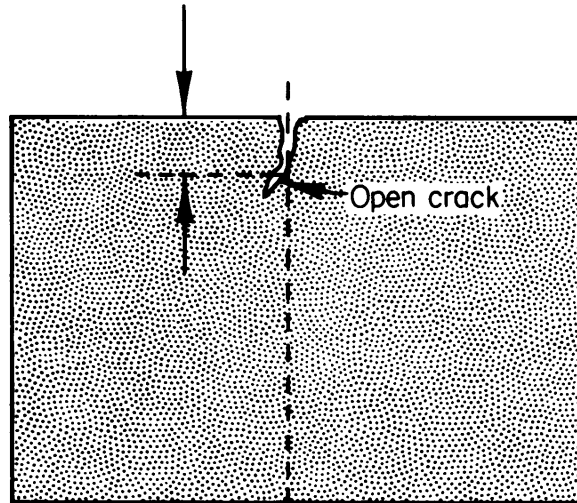
Figure 6-3. Diagram of Radiographic Exposure

6.1.6.1 It is the transmitted radiation intensity generally used to find a material defect. If the material discontinuity represented in Figure 6-4 were a foreign material inclusion, it also would cause a change in the apparent composition of the material and again result in a change in the transmitted radiation intensity. The degree of this change would be dependent on the relative effects of the test object and the included material on the incident radiation.

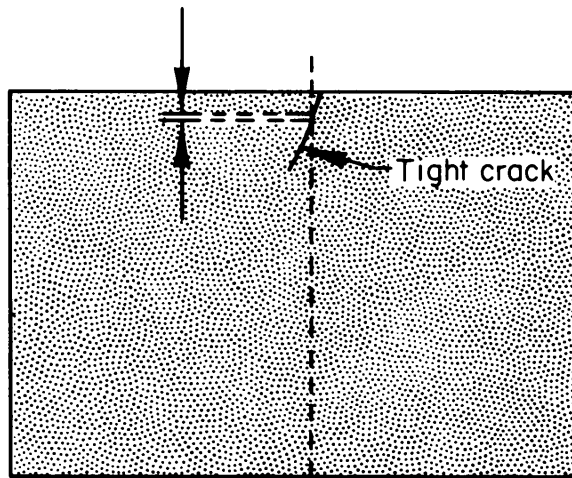
6.1.6.1.1 Some voids are difficult to detect, because they present a very slight change in material thickness to a beam of radiation. An important example of this type of defect is a crack, which represents a tear or rupture within a homogeneous material. If a crack is open, meaning the opening is wide (Figure 6-4 a), it appears to the radiation beam as a significant change in effective material thickness and is thus readily detected. However, if a crack is under compression and is very tight or closed, as illustrated in Figure 6-4 b), then its detection may become very difficult, if not impossible, because the apparent change in material thickness is negligible. It is important to note, crack orientation to the primary beam has a very significant effect on the detectability of the crack using a radiographic technique. If the crack in Figure 6-4 b were oriented parallel with the radiation beam, the effective change in material thickness would be enough to make the crack easily detectable. However, in most situations the probability of aligning a beam with a tight crack is low, so other NDI techniques SHOULD be relied upon as backup inspections. The problems associated with crack detection will be dealt with at length in later paragraphs.

NOTE

Although radiography will reveal the interior of opaque objects, it cannot detect all types of irregularities or discontinuities. Small defects such as fine cracks or indentations in thick objects are difficult to detect. In applying radiography as an inspection method, the sensitivity of the method must be kept in mind. The limitations of radiography will become more apparent in subsequent discussions.



a. Open crack



b. Tight crack

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Figure 6-4. Effect of Change in Thickness Cracks

6.1.7 Exposure of Film to Radiation. X- or gamma radiation differs from ordinary light in their action on photographic film. Examination of microscopic sections through the sensitive layer of exposed films has shown radiation, unlike light, produces an equal distribution of grains of reduced silver throughout the entire thickness of the layer, whereas light produces an effect mainly on the surface of the emulsion. Consequently, a greater blackening of the emulsion can be produced by increasing the thickness of the emulsion and by coating both sides of the base of radiographic film. This darkening effect MAY then be used to obtain a photographic record, or radiograph, which is produced by the passage of X-rays or gamma rays through an object and onto a film. Thus a radiograph is a shadow picture of an object and its interior; dark regions on the film represent the more penetrable regions of the part and lighter areas on the film represent the more dense areas of the part. Film MAY be coupled with various screens to improve the image and reduce problems associated with scattered radiation.

6.1.7.1 The term exposure, as used in this manual, refers to the amount of radiation energy reaching a particular area of the film. It could be expressed as “ergs-per-square-centimeter,” but it is more convenient for practical use when expressed in terms of “dimensionless-relative-units,” one particular exposure value being used as a reference for other exposures. Characteristic curves are used to relate the action of exposure to radiation on a film, which becomes apparent in varying degrees of blackening in the processed film.

6.1.8 When to use Radiography. Radiography satisfies the three primary requirements of any nondestructive inspection:

- There is an energy form that can be usefully produced in a controlled manner.
- This energy form is capable of interacting with material in a manner that causes a change in the energy form, but not in the material.
- After such interaction, the energy form MAY be detected and MAY be interpreted to define what material condition produced the observed result.

6.1.8.1 Guidelines for Using Radiography. Here are some basic guidelines that MAY be followed to determine situations in which radiography is applicable:

- The area/defect of interest must cause a detectable change in apparent thickness, density, or composition of the test material.
- The material SHOULD be reasonably homogeneous, so an indication of a defect can be recognized.
- The part SHALL be configured so the inspector will have access to both sides of the area that must be inspected. This is a requirement to ensure the area to be inspected is between the primary beam and the film.
- The defect to be detected SHOULD be properly oriented in the path of the radiation beam.

6.1.8.2 Limitations to Radiographic Inspection. Radiography is not a cure-all and SHOULD only be used when the above conditions are satisfied. Multiple film techniques and other special methods, which will be covered in [Paragraph 6.4.17.2.2](#), make radiography a versatile tool for material evaluation.

6.1.8.3 Typical Uses for Radiographic Inspection.

6.1.8.3.1 Radiography is a useful nondestructive inspection method for detecting internal discontinuities in many materials.

6.1.8.3.2 Radiography MAY be applied to the inspection of castings, welds, and assembled components. Various metals, both ferrous and nonferrous, as well as non-metallic substances, such as ceramics and plastics, can successfully be inspected.

6.1.9 Unique Properties of Gamma Radiation.

6.1.9.1 Introduction to Gamma Radiography. Gamma radiography is basically the same as X-radiography. The differences in material properties and effects between them are largely a matter of degree. The major advantage of using gamma rays over X-rays is the fact gamma ray sources are small and provide access to small spaces, thereby simplifying exposure technique. A downside to using gamma rays is the fact that the exposure period is generally longer with gamma ray sources, and the gamma ray source cannot be turned off like an X-ray unit can.

6.1.9.2 Phenomenon of Gamma Radiation. Many atoms exhibit a property called radioactivity, which is a phenomenon of spontaneous disintegration or decay. This characteristic is believed to be caused by the instability of the complex structure of the atom under the action of the electric, magnetic, and gravitational forces existing within. This energy release is uncontrolled and is a result of forces in the atom. Radium is one of the elements with a natural unbalance that releases energy in the form of gamma rays to achieve a more stable condition. Radium-226 has no gamma energies over 0.27 MeV. In addition to the gamma rays, some alpha particles (helium nuclei) and beta particles (electrons) are allowed to escape. The atomic structure of many materials can be artificially made to release energy by subjecting them to strong fields of neutrons generated in nuclear reactors. These neutron fields add energy to the atom, which upsets the balance within the nucleus and causes the atom to emit one or more types of energy. Cobalt is one element commonly made artificially radioactive and used in

NDI since the energy it releases is a very penetrating form of gamma rays. Co-60 has energies above 1 MeV. An example of nuclear disintegration and the release of energy is shown (Figure 6-5).

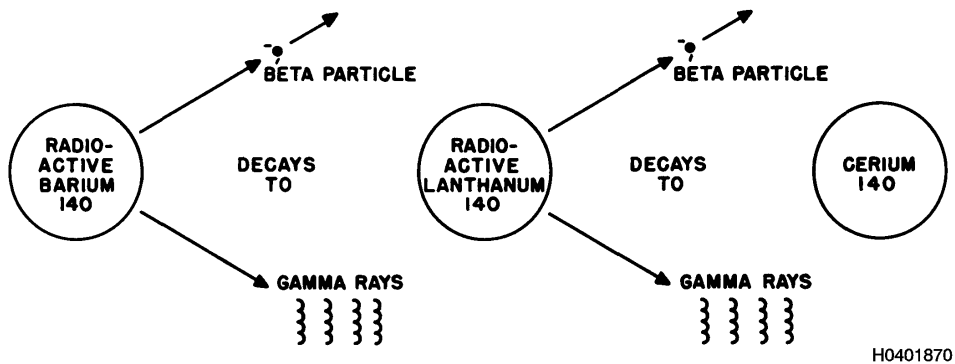


Figure 6-5. Diagram of Nuclear Disintegration

6.1.9.3 Typical Gamma Ray Source. The typical gamma ray source is composed of a metal container, called a camera, which contains a radioactive element, and has provisions to allow the element to be moved to a desired exposure position. Cameras are made of very dense material in order to shield the radioactive material. Typical gamma ray sources contain such artificially radioactive elements as cobalt -60, iridium -192, cesium-137, thulium-170, and ytterbium-169.

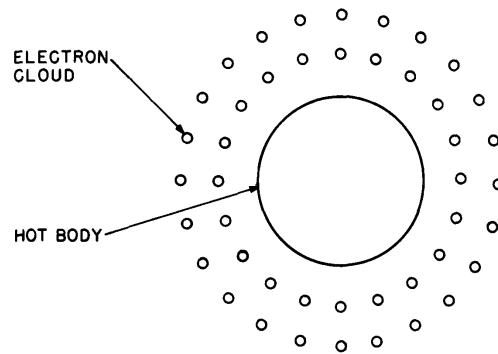
SECTION II PRINCIPLES AND THEORY OF RADIOGRAPHIC INSPECTION

6.2 HOW X-RAYS ARE PRODUCED.

6.2.1 Generating X-Radiation.

6.2.1.1 Basic Requirements. There are three basic requirements, which must be met to produce X-rays; 1) supply electrons, 2) move electrons, and 3) impinge electrons onto the target.

6.2.1.1.1 Supply Electrons. Since all matter is generally considered to be composed of electrons and other minute particles, electron sources are readily obtainable. Electrons can be supplied by simply raising the temperature of a suitable material. To excite the electron, it is necessary to sufficiently heat the material. As the temperature rises, the electrons become more and more agitated until they finally “escape” or “boil-off” the material. The excited electrons will surround the material in the form of an electron cloud (Figure 6-6), commonly known as thermionic emission. In an X-ray tube, the heated material is called the filament, which is similar to the filament in a light bulb. Just as in a light bulb the filament is heated by passing electrical current through it. This cloud of electrons simply hovers around and returns to the emitting substance unless some external action or force pulls it away. Therefore, electron emission is facilitated by heating a filament which is incorporated into the cathode.



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Figure 6-6. Electron Cloud

6.2.1.1.2 Move Electrons. As high voltage, direct current is applied between the cathode and the anode, the cathode emits electrons which flow toward the anode. This movement is brought about due to the repelling and attracting forces inherent in an electric circuit. The fundamental law of electrostatics states: “like charges repel and unlike charges attract.” Electrons are negative charges, thus repel each other, however, a stronger attracting force is needed to accelerate the electrons to a higher velocity. Therefore, a strong opposite (positive) charge is used to move the electrons from one point to another. This voltage force, which drives electrons from the cathode to the anode, is known as kilovoltage with a unit symbol “kV.” It is important this movement is conducted in a good vacuum; otherwise the electrons collide with air molecules and lose energy through ionization and scattering. In an X-ray tube, the anode (target) is given a positive charge with respect to the filament, which is part of the cathode. A focusing cup in the cathode is used to direct the stream of electrons to the target.

6.2.1.1.3 Impinge Electrons Onto the Target . The voltage applied between the cathode and anode is called the X-ray tube voltage, and the surface of the anode which is struck by electrons is called the target. When the rapidly moving electrons collide with the target stopping their rapid motion, a small portion of their energy is transformed into X-rays. The remainder of the energy is turned into heat, raising the temperature of the target (anode). Because the target is heated to extremely high temperatures, it is made of a high melting point material like tungsten.

6.2.1.1.3.1 The number of electrons emitted from the cathode and the dose of X-rays generated off the target of the anode can be adjusted by changing the filament current of the X-ray tube. When the X-ray tube voltage is changed, the speed at which electrons strike the target is changed, causing a change in the energy level of the X-rays and their wavelength. X-rays which have relatively short wavelengths are called hard X-rays, and those with relatively long wavelengths are called soft X-rays.

6.2.2 Type of Radiation Produced by a Tube Head.

6.2.2.1 The Continuous Radiation. When the electrons bombard the target, they are brought to an abrupt halt. Unfortunately most of the electrons’ kinetic energy is converted into heat, which must be dissipated by the target material. Only a small percentage of the energy available in the electron beam is converted into X-ray photons, which can have energies ranging from zero to a maximum determined by the original kinetic energy of the electrons and by how rapidly the electrons are decelerated. This process produces the continuous portion of the X-ray spectrum and is known either by the German term “Bremsstrahlung,” meaning braking radiation, or by the term “white radiation” ([Paragraph 6.2.7.1](#)). X-rays are produced regardless of the material bombarded, whether it is a solid, liquid, or gas. In the X-ray tube, a solid material is used for the target. For efficient X-ray production, the target material must have a high atomic number.

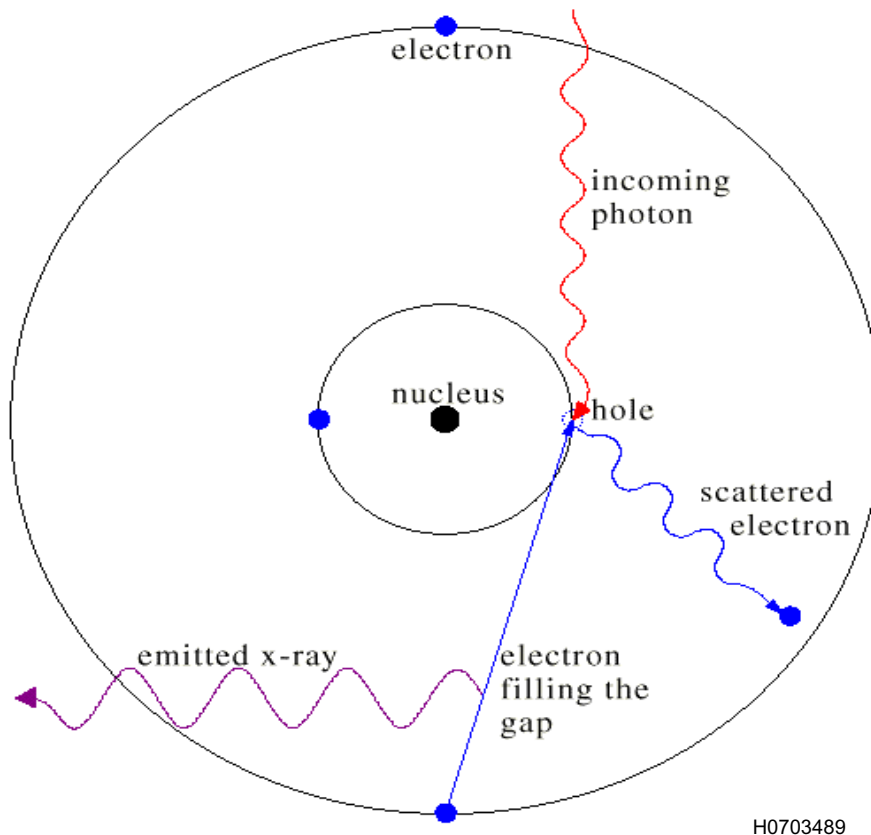


Figure 6-7. X-ray Production

6.2.2.2 Characteristic Radiation. In addition to “white radiation” ([Paragraph 6.2.7.1](#)), there are several other characteristic spikes in a typical X-ray spectrum. These intensity spikes are caused by interaction between the impinging stream of high-speed electrons and the electrons bound tightly to the atomic nuclei of the target material. If an atom is considered as a planetary system with the nucleus of protons and neutrons at the center and the electrons moving in orbits around the nucleus, modern physics predicts the orbital electrons near the nucleus will have very well defined energies, and electrons in different orbits having different energy levels. If an electron from an external beam collides with an orbital electron with sufficient energy, and knocks it from its orbit, an electron from a higher energy level would, after a time, drop down to fill the void and restore atomic stability. When that electron drops to the lower energy level, it gives off a photon with energy equal to the difference in energy levels ([Figure 6-7](#)). Since these energy levels depend strictly upon a particular atom, the radiation emitted is called “characteristic radiation.” The “characteristic radiation” emitted by the target material is superimposed upon the “continuous spectrum.” A typical X-ray spectrum of radiation generated by an X-ray tube would appear as [Figure 6-8](#). The K- and L- series of characteristic radiation designate the radiation emitted from different electron orbits around the nucleus of the atom. As energy levels increase, electrons are dislodged from the various orbits with the K-series being the closest to the nucleus.

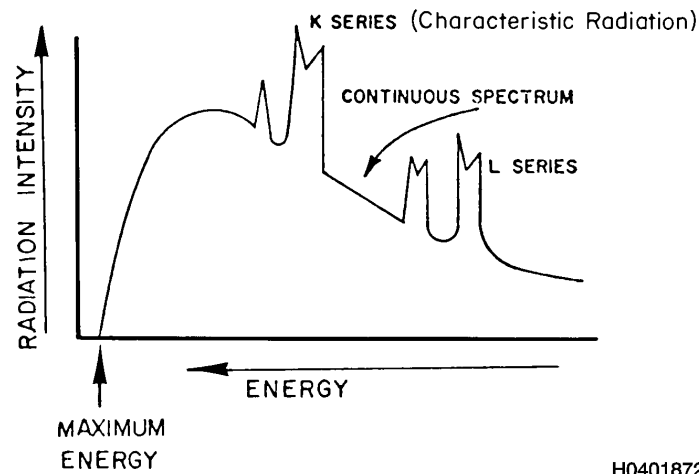


Figure 6-8. Typical X-ray Spectrum

6.2.3 Effects of Voltage and Amperage on X-ray Production.

6.2.3.1 Effect of Voltage. In different equipment, different methods are used to accelerate the electrons. In the smaller X-ray generators, up to and including two-million volt units, acceleration is accomplished with transformers to step-up the incoming power line voltage and applies it between the anode and the cathode of the X-ray tube. Since X-ray generators operate at very high voltages, the unit kilovolt (kV) is used to designate one thousand volts. As the kilovoltage (the potential causing the electrons to accelerate) is changed, the kinetic energy of the moving electrons is changed, altering the energy of the resulting X-radiation. Also, as the kilovoltage is increased, the efficiency of converting the electrical energy into X-rays is increased. Therefore, when kilovoltage is changed, the penetrating capability (the quality) of the generated radiation is changed, and the “quantity” of radiation is altered due to the efficiency of electrical energy converted into X-rays. Selecting the proper kilovoltage is very important in industrial radiographic applications.

6.2.3.2 Effect of Amperage. Amperage is a measure of the amount of electrical current applied to the filament. It is also a direct measurement of the number of free electrons available in the X-ray tube and is independent of variations in kilovoltage. Thus the “quantity” of X-radiation is in direct relation to the filament current. Typically, the amount of current is small, so the unit milliamperage (mA) is used to designate one one-thousandth of an ampere. The effect of mA changes on the radiation output is shown ([Figure 6-9](#)).

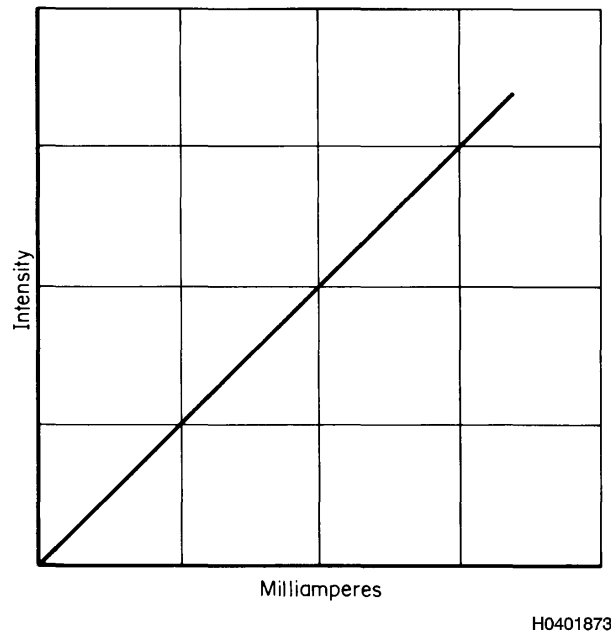


Figure 6-9. Effect of Filament Current on Radiation Quantity (Intensity)

6.2.4 X-ray Generators.

6.2.4.1 What are X-ray Generators. X-ray generators are man-made electronic devices designed to produce X-radiation. X-ray generators are obtained commercially and the equipment is either portable or stationary. Portable X-ray generators are used for inspection of test objects either impossible or very difficult to transport or safely inspect. Stationary X-ray generators are used in shielded facilities where the objects to be tested can be readily transported to the X-ray equipment ([Paragraph 6.3](#)).

6.2.4.2 Components and Properties of an X-ray Tube. The X-ray tube houses the cathode “negative terminal” and the anode “positive terminal” under a high vacuum. Traditionally, this tube has been a glass envelope with a reduced thickness at the window (the point where the X-rays exit) to reduce X-ray absorption. The high vacuum reduces the problem of the electrons colliding with, and being absorbed by, molecules of air and provides electrical insulation between the cathode and anode. In some designs, a “beryllium window” is incorporated to further reduce absorption of the X-ray beam, particularly the lower energies. In many applications metal-ceramic envelopes are replacing glass envelopes. These tubes usually involve a metal cylinder with a ceramic disk at each end to hold and insulate the cathode and anode assemblies. The metal-ceramic tube is more durable than the glass tube and is less susceptible to thermal and mechanical shock.

6.2.4.2.1 Glass Envelope. It is important this movement of electrons is conducted in a good vacuum; otherwise the electrons collide with air molecules and lose energy through ionization and scattering. A glass envelope with a strong vacuum is needed to ensure this happens.

6.2.4.2.2 Cathode. A structure known as the cathode serves as the electron source ([Figure 6-10](#)). Actually, it is a “filament” or “coil” of thoriated tungsten wire that emits electrons when heated to a high temperature. Since the filament gives off electrons in all directions, some means must be used to focus them on a target. The filament is centered within a “reflector” or “focusing cup” within the cathode structure and serves to focus the electron beam like a light is focused by a flashlight reflector.

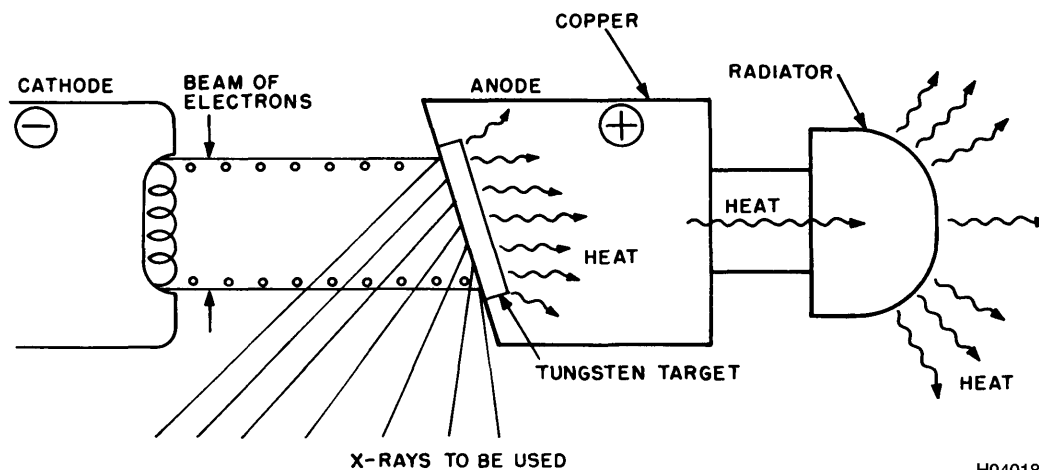


Figure 6-10. Fundamentals of X-ray Tube

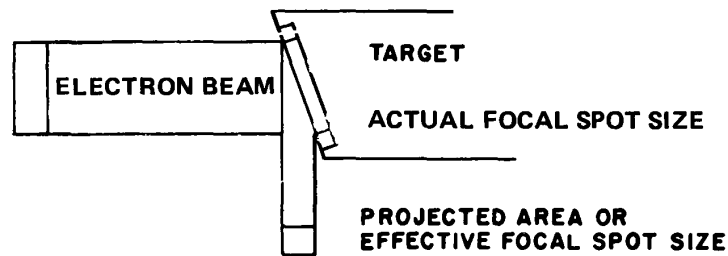
6.2.4.2.3 Focusing Cup. A negatively charged focusing cup is used to direct the stream of electrons toward the anode (target).

6.2.4.2.4 Anode. There must be a target for the electron beam to strike before X-rays are actually produced. In radiographic tubes the target material is generally made of tungsten. The choice of tungsten as a target for industrial radiography is based on four material characteristics:

- High Atomic Number (74). The higher the atomic number of a material the more efficient is the conversion from electrical energy into X-ray energy.
- High Melting Point (6170°F). Most of the energy in the electrons bombarding the target is dissipated in the form of heat. The extremely high melting point of tungsten (W) permits operation of the target at very high temperatures.
- High Thermal Conductivity. This permits rapid removal of heat from the target, allowing maximum energy input for a given area size.
- Low Vapor Pressure. This reduces the amount of target material vaporized during operation.

6.2.4.2.4.1 The tungsten (W) target material is usually imbedded into a massive copper rod. Copper is an excellent thermal conductor and is used to remove the heat from the target, which then, depending on tube design and operation, is dissipated by air, oil, or water-cooling. The tungsten target of the anode SHALL be at a positive potential (voltage) with respect to the cathode in order to attract electrons emitted by the filament.

6.2.4.2.5 Focal Spot. The focal spot is the area of the target bombarded by the electrons from the cathode. The focal spot is determined by the shape and size of the focusing cup of the cathode along with the length and diameter of the filament. The size of the focal spot has a very important effect upon the quality of the X-ray image. The smaller the focal spot, the better the detail of the image. The electron stream from the filament is focused as a narrow rectangle on the anode target. The typical target face is made at an angle of about 20-degrees to the cathode. When the rectangular focal spot is viewed from below, in the position of the film, it appears to be more like a small square. Thus, effective area of the focal spot is only a fraction of its actual area (Figure 6-11). By using the X-rays that emerge at this angle, a small focal spot is created, improving radiographic definition. Because the electron stream is spread over a greater area of the target, heat dissipation by the anode is improved.



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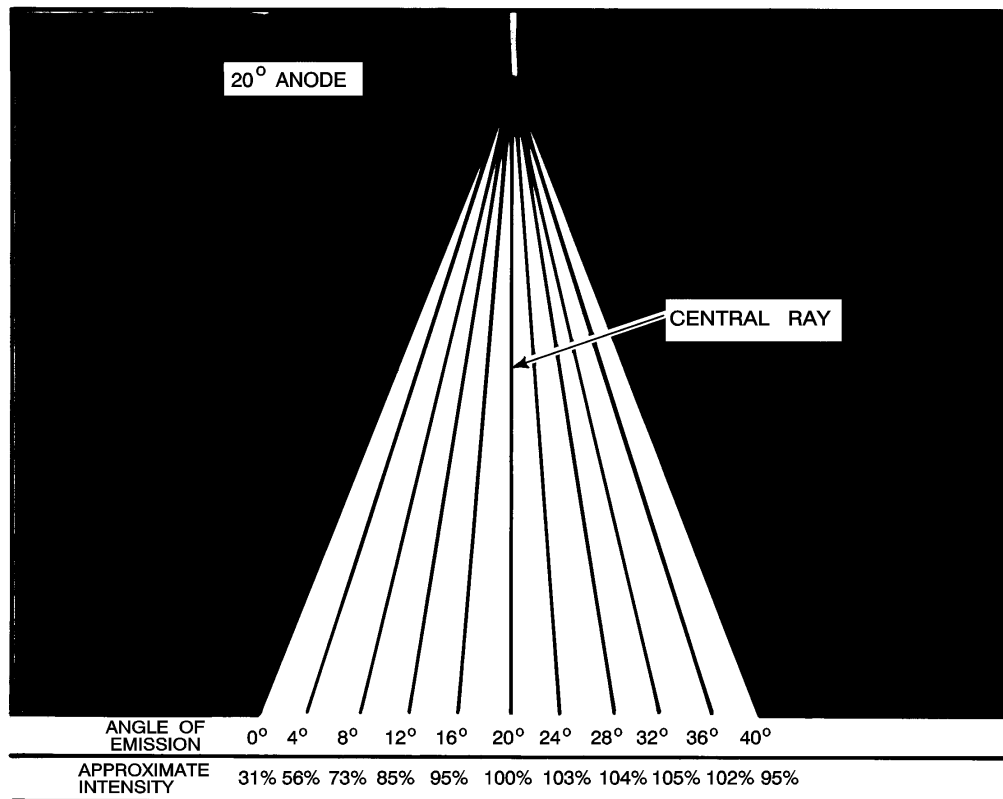
Figure 6-11. Effective Focal Spot Size

6.2.4.3 Inherent Filtration. Inherent filtration is the filtration or reduction in radiation energy due to absorption by the material necessary to provide the vacuum, the electrical insulation, and mechanical rigidity of the X-ray tube. In construction of some glass X-ray tubes, the port is reduced in thickness to provide less inherent filtration. In some other tubes, the port is made of beryllium, which is a light metal of low atomic number and low X-ray absorption. Because of tremendous pressures exerted by the atmosphere on large evacuated containers, X-ray ports must be designed with sufficient thickness to withstand these pressures without implosion. In center-grounded X-ray equipment, it is also necessary to provide gas (e.g., sulfur hexafluoride SF₆) and solid insulation for electrical isolation of the X-ray tube. Excessive inherent filtration reduces the X-ray output as well as the radiographic contrast on equipment of a given rating. In normal practice, it is acceptable to tolerate inherent filtration equivalent to 1 mm of aluminum up to 100 kV (kilovolts peak); 3 mm of aluminum up to 175 kV; 5 mm of aluminum equivalent up to 250 kV; and higher filtration in 1,000 to 2,000 kV units. Inherent filtration above these tolerances reduces contrast, and hence, the sensitivity of radiographic inspection, especially on thin sections and light alloys. For this reason, during radiographic inspections using kilovoltage of 150 kV or less, the tube head SHALL be configured so generated radiation will travel from the target through a beryllium window without passing through any media other than air or insulating gas.

6.2.4.4 Cooling Requirements. The product of mA and kV equals watts of electrical power in the electron beam striking the X-ray target. One watt of electrical power is equal to one volt-ampere. Therefore, in an X-ray tube operating at 10 mA (or 0.01 amperes) and 140 kV (140,000 volts), 1400 watts of electrical power are in the electron beam. Only a very small amount of the energy in the electron beam, about 0.05-percent at 30 kV to approximately 10-percent in the MeV energy range is converted into X-radiation. Most of the other electron beam energy is converted into heat. This heat in the X-ray tube target material is one of the limiting factors in the capabilities of the X-ray tube. Thus, it is necessary to remove this heat from the target as rapidly as possible. Various techniques are used for removal of this heat. In some instances, the target is comparatively thin, and requires a suitable oil to be circulated on the back surface to remove the heat. In other cases, (where the anode is being operated at ground potential) use a water-antifreeze mixture to conduct heat away from the target. Most X-ray targets are mounted in copper, which is used as a heat sink. Some units have no external method of heat removal, but depend upon heat dissipation into the atmosphere by the fins of a thermal radiator. Some totally enclosed tubes depend upon the heat storage capacity of the anode structure to absorb the heat generated during X-ray exposure. This heat is then dissipated after the unit is turned off. These units usually have a duty cycle limiting the operation. This duty cycle is dependent upon the heat storage capacity of the anode structure and the rate of heat dissipation by thermal radiation. The rate of heat removal from the X-ray target is the primary limiting factor in X-ray tube operation.

6.2.5 Intensity and Distribution of an X-ray Beam.

6.2.5.1 Heel Effect. For simplicity's sake, most literature states the intensity of radiation of the primary beam is constant, this is not quite correct. There is a variation in intensity due to the angle at which X-rays are emitted from the focal spot. This variation in intensity is called the heel effect ([Figure 6-12](#)).



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Figure 6-12. Variation of Intensity in the Primary Beam Due to the Heel Effect

6.2.5.1.1 The intensity of the beam diminishes rapidly from the central ray toward the anode side and increases slightly toward the cathode side. In general practice, the heel effect is not evident, provided the maximum lateral dimension of the object to be radiographed is less than half the source-to-film distance (SFD). In other words, coverage of a 14-inch by 17-inch film requires an SFD of approximately 36-inches to provide a field intensity of plus or minus 12-percent over the entire film. This is based upon using part of the radiation field within a cone having a 30-degree included angle. Remember, the source for an X-ray tube is the focal spot. For a single exposure of larger areas requiring multiple films, the SFD must be increased. A detailed example for figuring the heel effect is in [Paragraph 6.7.9](#).

6.2.5.2 **Beam Coverage.** The greater the field size available from an X-ray unit, the greater its radiographic inspection capacity. Except at extremely high voltages, the X-ray beam has an angle of coverage that is a function of the X-ray target angle, the geometry of the focal spot, and the X-ray port size. As indicated in the discussion on “heel effect” in the previous paragraph, the physical size of the field of uniform intensity increases directly in proportion with the distance from the target to the film. However, the beam intensity decreases proportionally with the square of the distance. As a result, the exposure (product of amperage and time) must be increased to produce equivalent density on the radiograph. If a technique has been established but the situation requires a different SFD ([Table 6-2](#)), use these multiplication factors for calculating new exposure times to be used with the original kV and mA values.

NOTE

To change the SFD from any given distance to any desired distance, locate the given distance on top of the chart. Next, read down the left side of the table to the desired distance. Multiply the original exposure by the number common to both the distance in the given column and the distance in the desired row to get the new exposure. This chart MAY be used for distance changes providing the kV and mA levels are not changed.

Table 6-2. Exposure-Time Correction Factors for Different Source to Film Distances

↓	Desired Distance (Feet)										Given Distance (Feet)									
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20
1	0.25	0.11	0.06	0.04	0.03	0.02	0.01	0.01	0.01	0.01	0.01	0.01	0.01	0.01	0.01	0.01	0.01	0.01	0.01	0.01
4	1	0.44	0.25	0.16	0.11	0.08	0.06	0.05	0.04	0.03	0.03	0.02	0.02	0.02	0.02	0.02	0.01	0.01	0.01	0.0
9	2.3	1	0.56	0.36	0.25	0.18	0.14	0.11	0.09	0.07	0.06	0.05	0.05	0.05	0.04	0.04	0.03	0.03	0.02	0.02
16	4	1.8	1	0.64	0.44	0.33	0.25	0.20	0.16	0.13	0.11	0.09	0.08	0.07	0.06	0.06	0.05	0.04	0.04	0.04
25	6.3	2.8	1.6	1	0.69	0.57	0.4	0.31	0.25	0.21	0.17	0.15	0.13	0.11	0.10	0.09	0.08	0.07	0.06	0.06
36	9	4	2.3	1.4	1	0.73	0.56	0.44	0.36	0.30	0.25	0.21	0.18	0.16	0.14	0.12	0.11	0.10	0.09	0.09
49	12.3	5.4	3.1	2	1.4	1	0.77	0.60	0.49	0.40	0.34	0.29	0.25	0.22	0.19	0.17	0.15	0.14	0.12	0.12
64	16	7.1	4	2.6	1.8	1.3	1	0.80	0.64	0.53	0.44	0.38	0.33	0.28	0.25	0.22	0.20	0.18	0.16	0.16
81	20.3	9	5.1	3.2	2.2	1.7	1.3	1	0.81	0.67	0.56	0.48	0.41	0.36	0.32	0.28	0.25	0.22	0.20	0.20
100	25	11.1	6.3	4	2.8	2	1.6	1.2	1	0.83	0.69	0.59	0.57	0.44	0.39	0.35	0.31	0.28	0.25	0.25
121	30.2	13.4	7.6	4.8	3.4	2.5	1.9	1.5	1.2	1	0.84	0.72	0.62	0.54	0.47	0.42	0.37	0.34	0.30	0.30
144	36	16	9	5.8	4	2.9	2.3	1.8	1.4	1.2	1	0.85	0.73	0.64	0.56	0.50	0.44	0.40	0.36	0.36
169	42.2	18.8	10.6	6.8	4.7	3.4	2.6	2.1	1.7	1.4	1.2	1	0.86	0.75	0.66	0.58	0.52	0.47	0.42	0.42
196	49	21.7	12.3	7.8	5.4	4	3.1	2.5	2	1.6	1.4	1.2	1	0.87	0.77	0.68	0.61	0.54	0.50	0.50
225	56.2	25	14	9	6.3	4.6	3.5	2.8	2.2	1.9	1.6	1.3	1.1	1	0.88	0.78	0.69	0.62	0.56	0.56
256	64	28.4	16	10.2	7.1	5.2	4	3.2	2.6	2.1	1.8	1.5	1.3	1.1	1	0.89	0.79	0.71	0.64	0.64
289	72.2	32.1	18.1	11.6	8	5.9	4.5	3.6	2.9	2.4	2	1.7	1.5	1.3	1.1	1	0.89	0.80	0.72	0.72
324	81	36	20.2	13	9	6.6	5.1	4	3.2	2.7	2.3	1.9	1.6	1.4	1.3	1.1	1	0.89	0.81	0.81
361	90.2	40.1	22.6	14.4	10	7.4	5.6	4.5	3.6	3	2.1	1.8	1.6	1.4	1.2	1.1	1.1	1	0.90	0.90
400	100	44.4	25	16	11.1	8.2	6.3	4.9	4	3.3	2.8	2.4	2	1.8	1.6	1.4	1.2	1.1	1	1

6.2.6 Interaction of Radiation With Matter.

6.2.6.1 Absorption Mechanisms. Absorption of gamma or X-radiation by materials requires detailed consideration. These radiation photons are electromagnetic waves of energy, have no mass or electrical charge, and can penetrate the densest of materials. These waves are dimensionally so short they have wavelengths less than the electron spacing in the atoms and therefore have the capability of traveling through the atomic structure. The absorption of the photons is a result of the photon either striking an electron or entering the nuclear field of the atom. The energy lost by a radiation beam as it travels through matter is due to interactions of the photons with matter. In these interactions, the energy of the photon is transferred principally through three processes. These are “photoelectric absorption,” “Compton effect,” and “pair production” ([Figure 6-13](#)). At extremely high photon energies a small amount of absorption is due to the photodisintegration process, but this is of little consequence in radiographic applications. Most of the radiation absorption is due to interaction of the photons with electrons in the atoms of the absorbing material. Therefore, an absorber may be judged somewhat in relationship to the electron density of the absorber, or approximately the number of electrons in the radiation beam path. The parameters that contribute to this electron density are the atomic number, the density, and the thickness of the absorber. The atomic number is the number of protons in the nucleus of the particular atom, and material density (usually expressed as grams per cubic centimeter) is related to the number of atoms compacted in a given material volume. The thickness of the absorber can be mechanically measured. Atomic number, material density, and absorber thickness combine to present an absorber value to the radiation. The radiation photons interact with the atoms in the absorber in different manners, depending upon the energy or wavelength of the photon.

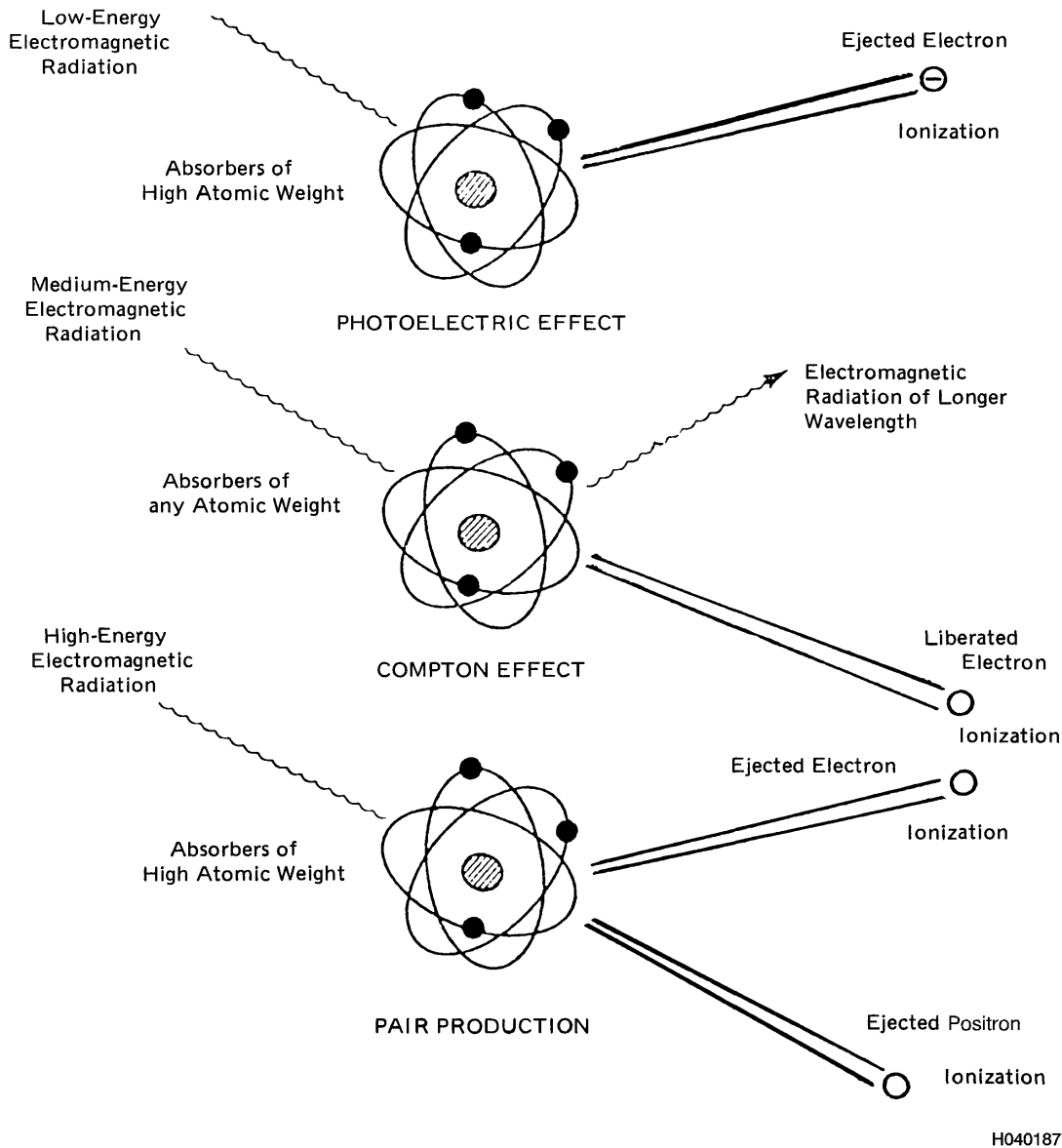


Figure 6-13. Illustration of Various Radiation Absorption Interactions

6.2.6.1.1 Photoelectric Absorption. When the photons have energies of 100 keV or less, they are readily absorbed by the electrons in the orbital shells of the atoms of the absorber. The energy of the photon is transferred to the electron; often dislodging it from its orbit and the remainder of the photons energy is used to give the electron kinetic energy or velocity. These ejected electrons are called “photoelectrons” and the process is known as “photoelectric absorption.” The moving electrons lose their energy through Coulombic interactions and can produce ion pairs.

NOTE

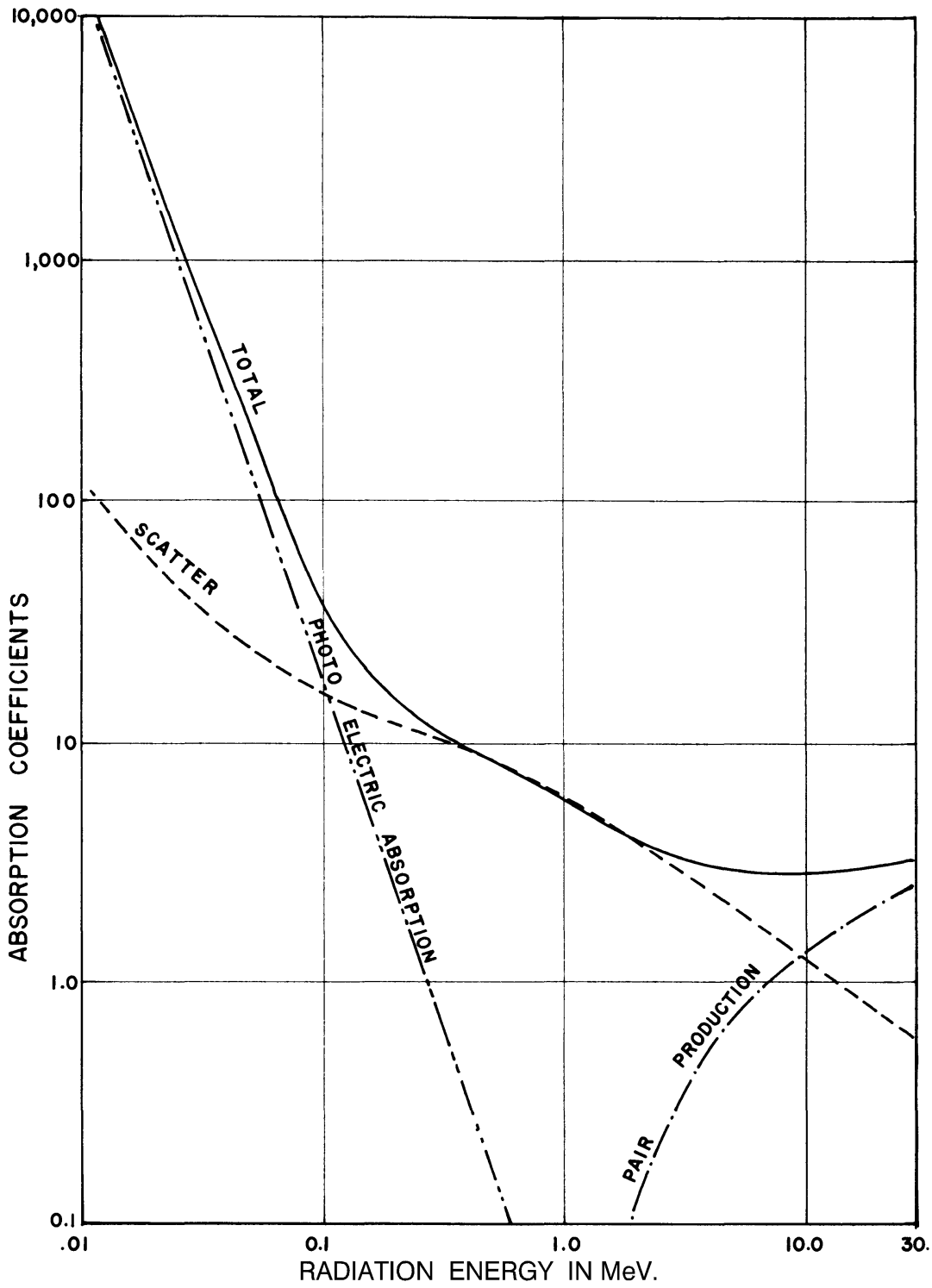
During this process, the radiation photon has given up all of its energy and no longer exists. This mechanism of absorption has a very high probability for very low energy radiation and accounts for the major absorption of radiation when photon energies are 100 keV and less.

6.2.6.1.2 Compton Effect (Scattering). When the photon energies are in the 100 keV to 10 MeV range, all of the energy is not required to dislodge an orbital electron and accelerate it by induction of kinetic energy. In this case, photoabsorption

can occur, but the photon continues at some different path and at a reduced energy level, due to the loss of energy to the electron. By this mechanism of absorption, the path of the photon is altered and its energy decreased. This mechanism of absorption is referred to as Compton Effect or Compton Scattering. Compton Effect accounts for the major absorption of radiation in the energy range between 100 keV and 10 MeV.

6.2.6.1.3 Pair Production. When photon energies exceed 1.02 MeV, their energy can cause pair production. In this event, the nuclear field surrounding the nucleus of the atom disintegrates the high-energy photon. The energy of the photon converts into an electron-positron pair. The positron has the same mass as an electron and is of equal, but opposite charge. It may be noted in this absorption mode, the energy of the massless photon is converted to mass. Einstein's equation states energy equals mass times the square of the velocity of light ($E = mc^2$). If this equation is used, it can be found the mass of an electron is equivalent in energy to a 0.51 MeV photon. This explains the requirements for a photon to have energy of at least 1.02 MeV before pair production can occur. Additional energy above the 1.02 MeV causes the pair of particles to have kinetic energy or velocity. The positron may cause ionization or it may combine with an electron, causing annihilation and emission of two gamma photons of 0.51 MeV per photon. These lower energy photons may subsequently interact by either the photoelectric or Compton Effect absorption modes.

6.2.6.2 Significance of Absorption Mechanisms. With three different absorption mechanisms, it is evident an absorber, when bombarded by photons of electromagnetic radiation, has absorption characteristics highly affected by photon energy. A graph illustrating the three major modes of absorption ([Figure 6-14](#)) is how they contribute to the total absorption in the element iron with its atomic number of 26. It should be noted from ([Figure 6-14](#)) nearly all of the absorption of radiation below 100 keV is due to the photoelectric effect. This absorption is highly dependent upon the atomic structure and the binding energies between the electrons and the nucleus. Therefore, the atomic number of the material will greatly affect radiation absorption by the photoelectric effect. When radiation energy is between 100 keV and about 10 MeV, absorption is almost entirely due to Compton Effect and atomic number is no longer the major criteria of absorption; instead, material density is the major controlling factor. In the energy range between 10 and 100 keV, radiation absorption is very sensitive to keV changes; a unit change in keV will cause three units of change in the atomic absorption coefficient. For energies between 200 keV and about 3 MeV a unit change in keV will only cause half a unit change in the atomic absorption coefficient, so the absorber is much less sensitive to changes in radiation energy. When the radiation energy is between 3 and 30 MeV, the atomic absorption coefficient is for practical purposes unchanged.



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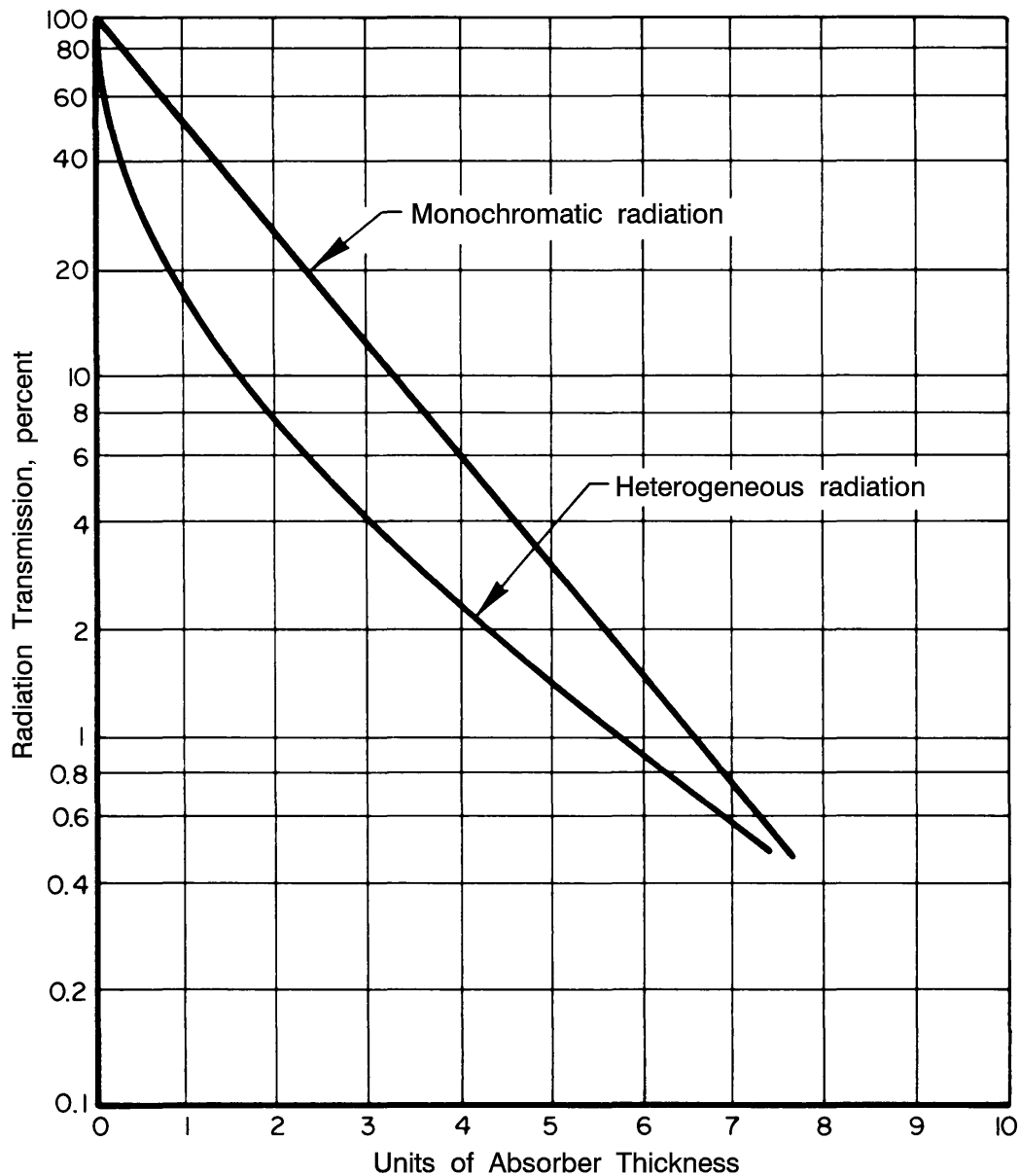
Figure 6-14. Absorption Coefficients for Different Modes of Absorption in Iron

6.2.6.3 Real Life Absorbers. In industrial applications, test specimens are being bombarded by the radiation photons, which are absorbed and scattered. In this process, electrons are ejected from the atoms of the test material. These absorbers are not ideal; they do not act as an ideal absorber in that they do not attenuate radiation in accordance with theoretical physics. Electrons, degenerated scattered photons, characteristic radiation from the test material, and some of the primary beam are all present on the film side of the test object simultaneously. The classical attenuation equation does not consider all these various components, so it is not strictly applicable in actual radiographic practices.

6.2.6.4 Diffraction Patterns. In the radiography of very coarse grain structure materials, such as inconel and cast irons, diffraction patterns are often revealed in the radiographic image. These patterns are due to the selective diffraction and absorption by the atoms of a definite pattern in the crystal structure. The definitive pattern of the atoms of a crystal can be aligned with the X-ray beam at a particular angle, so the radiation is altered in its direction of travel and concentrated upon the film as a linear indication. These crystalline diffraction patterns are superimposed upon the radiographic image and make interpretation very difficult. Often these dense, sharp lines caused by the crystal diffraction are interpreted as internal cracks. If uncertainty exists as to interpretation of a particular indication, a second radiograph can be made at a slightly different angle (less than 10 degrees difference). It is unlikely the crystal causing the diffraction pattern would be located in precisely the same relative position as to cause the diffracted line to strike the film in the same relative position. Changes in radiation energy will also affect diffraction patterns. Often by changing the operating kilovoltage, the problem of diffraction patterns can be reduced.

6.2.7 Radiation Energy.

6.2.7.1 White Radiation. Radiation generated by an X-ray tube contains various energies and therefore is referred to as white radiation ([Figure 6-15](#)). The X-rays are a continuous spectrum and the beam is selectively attenuated as it passes through an absorber. The low energy radiation is highly absorbed by the first few layers of the absorber medium and the spectral distribution is altered by this selective absorption. Thus, as an absorber is absorbing the white radiation, the attenuation rate more nearly approaches monochromatic radiation. [Figure 6-15](#) shows a semi-logarithmic graph of the absorption of a monochromatic beam and a multienergy beam of white radiation. For approximate estimations of effective X-ray attenuation coefficients, it may be assumed the average energy of an X-ray beam is about 50-percent of the peak operating kilovoltage for glass window tubes and 30-percent for beryllium window X-ray tubes.



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Figure 6-15. Absorption Curves of Monochromatic and Multi-Energy Radiation

6.2.8 Scatter Radiation.

6.2.8.1 Description of Scatter Radiation. When high-energy electromagnetic radiation bombards matter, some of the radiation photons are scattered by electrons. This process is called the Compton Effect. If the photon has a greater quantity of energy than necessary to eject an electron from its orbital path, it continues to travel with a loss of energy at some angle to its original path. The photon energy must be reduced to a very low value before complete annihilation is possible by photoelectric absorption. In low atomic number materials the photon direction is changed with little loss of energy and its energy must be reduced to a very low energy to be absorbed completely. Thus, a single photon might scatter many times, losing all semblance of its original path. If this scattered photon strikes the film, it reduces the image definition since it exposes the film at a spot other than directly under the point where it first entered the test material. High atomic number materials rob the photon of greater amounts of its original energy and also have much higher photoelectric absorption values. These more quickly reduce the photon energy to the point where the photon is completely absorbed. For these reasons, low atomic number

materials transmit larger quantities of scattered radiation than high atomic number materials. More information on scatter radiation can be found in [Paragraph 6.4.2.11](#).

NOTE

Low atomic number materials SHOULD be removed from the beam to the extent possible, to prevent scattering of the primary beam. Wood, concrete, or other low atomic number materials in the radiation beam SHOULD be covered with lead or a high atomic number material to reduce the scatter. In actual practice this means tables, floors, or walls behind/beside and close to the test part SHOULD be covered with lead.

6.2.8.2 Scatter Radiation Build Up. Scattering is due to photon collision with electrons in their path. As material thicknesses increase up to a critical thickness, the amount of scattered radiation emanating from the material increases. If additional thicknesses of material are added, the scattered radiation generated in these added layers has insufficient energy to penetrate the material between them and the film. The amount of scattered radiation emanating from the back of a part under inspection increases with part thickness up to a total, which varies with radiation energy. Since absorption due to the Compton Effect decreases with increasing radiation energy, less scattering occurs at higher radiation energy levels. Build-up scatter radiation can introduce contrast problems in the radiography of low atomic number materials such as graphite, plastics, and magnesium.

6.2.9 Material Contrast.

6.2.9.1 Material Contrast Factor. In consideration to radiation absorption, the most important variable that can be controlled by the radiographer in industrial X-ray inspection is the kilovoltage. The amount of radiation absorbed by the part being inspected depends on the atomic number, density, and thickness of the material. The radiographer cannot change these factors, but can change the energy of radiation in the attenuation equation:

$$I = I_0 e^{-\mu x}$$

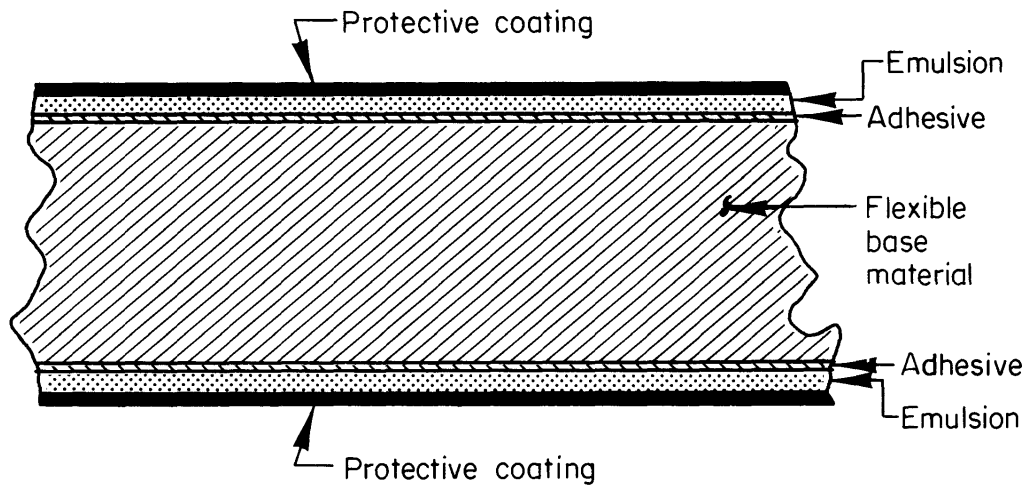
The linear attenuation coefficient (μ) can be changed by changing radiation energy. This in turn will change the percent-age radiation transmitted through a part of thickness, x . In industrial radiographic applications, the difference in thickness (often due to discontinuities) is the actual parameter from which interpretation is made. Therefore, the greater the change in the radiation transmitted due to a particular change in material thickness, the more obvious is the thickness change revealed in the final image. This radiation difference due to material thickness change is called the material contrast. The material contrast is a function of the absorption characteristics of the part being inspected and the radiation energy level. When measurements have been made and a numerical value has been established, it is called the material contrast factor.

6.2.9.2 Percent Radiation Transmission. When monochromatic radiation is used, the percentage of radiation transmission can be calculated from the formal laws of attenuation. Since this condition seldom exists in actual practice, the percent of radiation transmitted must be empirically measured. When the proper recorder is used, the actual measurements will include the scattered radiation as well as the transmitted primary beam, both of which can be expected to expose a film or interact with any other recorder in a typical industrial radiographic set-up.

6.2.10 Understanding Radiographic Film.

6.2.10.1 Function of Radiographic Film. Films can be used as a recording medium because their emulsions are sensitive to the quantity and the energy of electromagnetic radiation over a wide spectral range. In the photographic process, the electromagnetic radiation of the visible spectrum is focused with a lens on the film surface to record the variations of light intensities and form an image. In radiographic applications, the radiation is of such high energies they cannot be focused by a lens. In radiography, recording the variations in radiation quantities caused by absorption and scattering by the test specimen forms a shadowgraph of the test object. After final processing, film exposed with X- or gamma rays is called a radiograph; film exposed by using a radioisotope might be called a gammagraph. Films are an excellent recording medium with a very high signal-to-noise ratio and high amplification. This section describes how films work and reviews how films respond to radiation.

6.2.10.2 Structure of Industrial Radiographic Film. Industrial X-ray film consists of an emulsion and a blue tinted base of polyester. The schematic structure of radiographic films is below ([Figure 6-16](#)).



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Figure 6-16. Sketch of Cross Section of X-ray Film

6.2.10.2.1 Adoption of a Polyester Base. It has been many years since flammable cellulose nitrate film base was replaced first with inflammable cellulose acetate then with polyester base materials. Polyester base materials have advantages because they provide flatness and great strength. Little expansion and contraction takes place and the material is not hygroscopic. These advances in a polyester film base are indispensable to rapid film transport in automatic processors.

6.2.10.2.1.1 Polyester Base. Most modern films have a polyester base which is either transparent or has a slightly blue tint. The polyester is very durable, does not absorb water or processing chemicals, is dimensionally stable, dries easily, and will not support combustion. The polyester base is approximately 175 μ thick.

6.2.10.2.2 Emulsion. The emulsion consists of silver halide crystals as photosensitive material, plus additives and gelatin. The silver halides form an image when exposed by X-rays, gamma rays, secondary electrons, or fluorescent light. The emulsion in films used for general photography is coated only on one side of the base, whereas it is coated on both sides of most industrial X-ray films. Since the thin support material offers very little absorption to the X-rays normally used for industrial applications, the double emulsions essentially reduce exposure requirements to one-half that required for a single emulsion, however, some films intended for radiography in which visibility of the smallest detail is required, have emulsion only on one side. The absorption of high energy X-rays or gamma rays is increased by using two emulsion layers so the photosensitive silver compound is utilized more effectively for the absorption of radiation and electrons. Furthermore, the two emulsion layers help to increase contrast and image density of the radiographs. Each layer of emulsion is approximately 10 to 15 μ thick.

6.2.10.2.3 Outer Protective Layer. The emulsion may be coated on one or both sides of the base in layers and protected on both sides with very thin outer protective layers. Each outer protective layer is approximately 1 μ thick.

6.2.10.3 Latent Image. The latent image is formed by interactions of the electromagnetic radiation with the silver bromide crystals. When solid silver bromide is formed in the manufacture of film, the silver atoms give up an orbital electron to a bromine atom. Since the silver atoms have given up an electron, they have a positive electrical charge and are silver ions (Ag^+). The bromine atoms have acquired this negative electron and have become bromide ions (Br^-). The silver bromide crystal is a cubical array of the silver and bromine ions. The cubical crystalline structure of the silver bromide crystal is not perfect; if it were, the photographic process could not exist. Within the crystal lattice structure are extra silver ions called interstitial ions; these do not occupy a lattice position in the crystal. There are also foreign molecules or dislocations (distortions) of the crystal array within the crystal, all of which form latent image sites.

6.2.10.3.1 The accepted theory of the formation of the latent image (an image which may be revealed by development) in a photosensitive emulsion is based upon the Gurney-Mott concept of exposure. It is theorized the formation is a two-step process. The electromagnetic radiation ejects an electron from the negatively charged bromine ion in the crystalline structure, thus converting the ion into a bromine atom. The free electron can travel within the crystal to a dislocation or other latent image site where it is trapped, establishing a negative electrical charge at that point. This negative electrical charge attracts one of

the positively charged interstitial silver ions to the latent image site. When the silver ion reaches the image site, the negative electron counteracts its positive charge and it becomes neutralized and exists as a silver atom. The latent image site is now electrically neutral. This process MAY be repeated several times, adding silver atoms to the latent image site in the crystal. These few silver atoms act as a catalyst for reducing action of the developer, thus making the entire emulsion grain susceptible to conversion to metallic silver in development.

6.2.10.4 Films Reaction to Development. The developing agent selectively reduces those crystals containing latent images into black metallic silver, but has a much smaller effect on those crystals not exposed. The metallic silver is opaque and forms the radiographic image.

6.2.10.4.1 Theory of Film Developer. The purpose of the developing solution, or developer, is threefold. First, it blackens those parts of the emulsion exposed (e.g., when a crystal of the film's silver bromide emulsion has been exposed to X-ray radiation and is put into a developing solution, the developer takes the bromide away from the silver and leaves black metallic silver in the gelatin). Where full exposure has occurred, a maximum number of crystals are affected and almost all of them are reduced by the developing solution to metallic silver. Second, it produces various shades of gray where the film has been only partially exposed. These grays are the result of partial removal of bromide. The concentration of black metallic silver per unit area of the film is dependent upon the amount of exposure received, and determines the factor known as "film density". The image of the object radiographed consists of varying densities spread over the film, corresponding to the varying amounts of exposure received by the film. Third, is its effect on those parts of the film which have received no exposure. Since no crystals were affected, the developer SHOULD leave these parts unchanged. Thus, a developing solution SHOULD remove bromide from the film emulsion where exposure has occurred, but SHOULD NOT produce effect on unexposed areas of the film.

6.2.10.4.1.1 A very limited number of chemicals possess the ability to distinguish between exposed and unexposed crystals and therefore only a few are suitable for use in developers. No chemical known will leave an unexposed area indefinitely unchanged. All will begin to develop unexposed parts after a period of time, producing a condition called "chemical fog." All developing agents have a definite fogging time beyond which bromide will be freed in unexposed areas.

6.2.10.5 Image Quality. Microscopic variations in the response of film to the incident radiation produce effects of considerable practical significance. The number of sites where the silver atoms can respond to the radiation vary in location throughout the emulsion and are inversely proportional to the size of the silver bromide grains. Thus, after exposure to radiation, the density of the image will vary. The larger the number of sites activated by radiation, the larger the number of silver atoms per unit area, and, statistically, the smaller the density variations. The practical factors are:

6.2.10.5.1 Graininess. The graininess of the film is the visual impression of non-uniformity of density in a radiographic image. Graininess increases with increasing film speed and with increasing energy of the radiation. Apart from the visual appearance of graininess, the effect may be subjected to physical measurements. This measured property is referred to as "granularity." This term has been adopted as an expression for physical measurements of the statistical fluctuations of density over the area of a photographic emulsion. Obtain granularity measurements by scanning a sample of emulsion with a small spot of light (diameter of the order of 0.08 mm) and record the resulting irregular fluctuations of the transmitted light.

6.2.10.5.2 Signal-to-Noise Ratio. The accidental variation in image density makes it more difficult to identify the deliberate variation in image density resulting from use of the film. The relationship between the two density variations is known as the signal-to-noise ratio. The ratio for threshold visibility of detail SHALL be at least five.

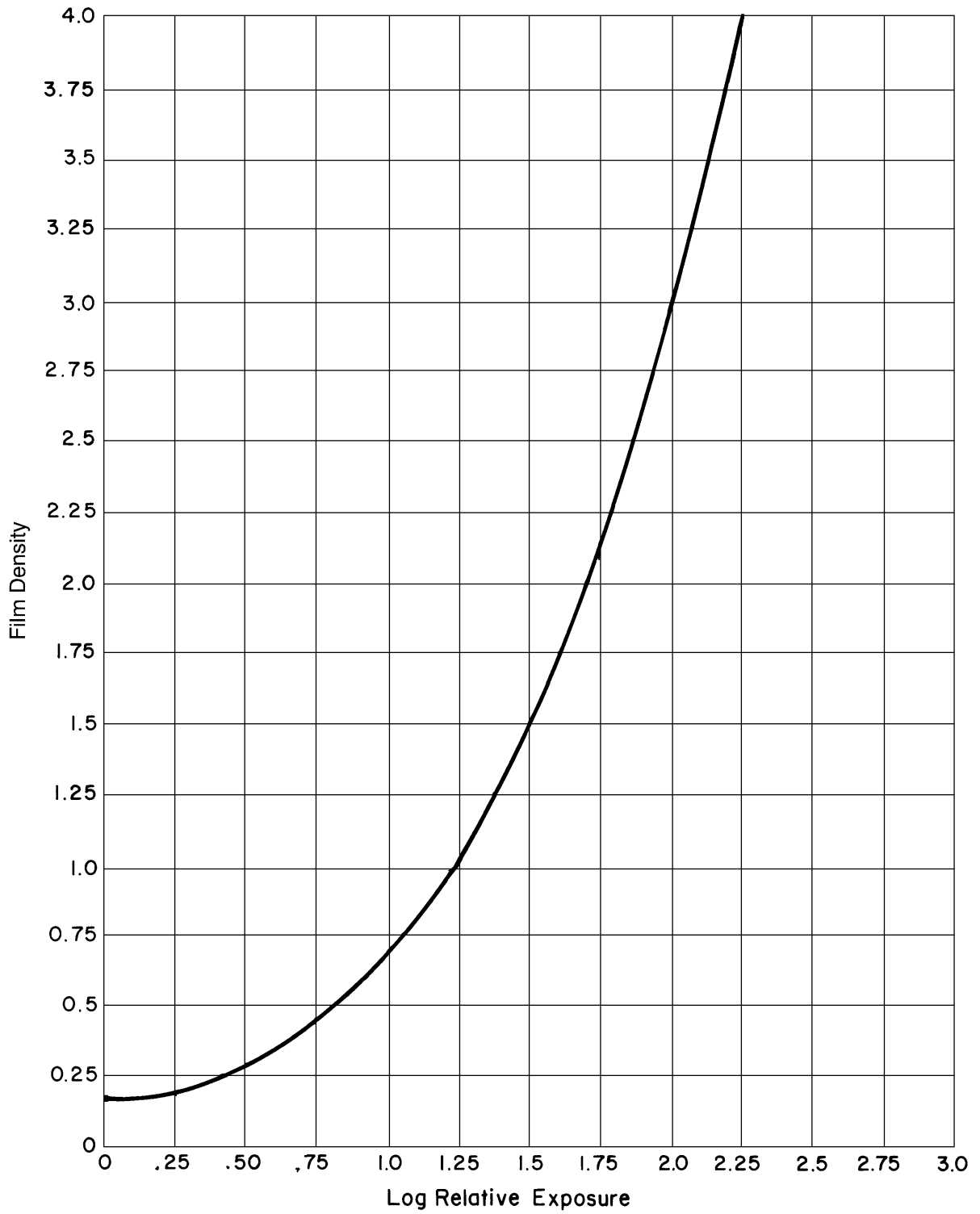
6.2.10.6 Film Image Density. In photographic usage, density is a measure of the degree of blackening of the processed film caused by exposure to radiation. Film image density is the logarithm of the reciprocal of the fraction of light transmitted through the film with respect to the light incident on the film and is discussed further in [Paragraph 6.7.5](#).

6.2.10.6.1 The relationship of light transmission and density are in [Table 6-3](#). A typical density used in practical radiography is 2.0 and represents 1-percent transmittance.

Table 6-3. Relationship of Light-Transmission to Film Density

Transmittance (I_T / I_0)	Percent Transmittance (I_T / I_0) x 100	Opacity (I_0 / I_T)	Film Density $Log_{10}(I_0 / I_T)$
1.00	100	1	0
0.50	50	2	0.3
0.25	25	4	0.6
0.10	10	10	1.0
0.01	1	100	2.0
0.001	0.1	1,000	3.0
0.0001	0.01	10,000	4.0

6.2.10.7 Characteristic Curve. The characteristic curve is the response of a type of film to radiation of a particular energy. It is obtained by plotting the correlation between the film-image density against the logarithm of relative exposure. Since density is a logarithm ([Paragraph 6.7.6](#)), log-log scales are used for the plot. Log-log scales not only make interpretation of the graph easier, but also the important values of relative exposure can be derived easily by subtracting one logarithm value from another. At low exposures, a large change in exposure is needed to produce a significant change in density ([Figure 6-17](#)). As relative exposure increases, the film emulsion becomes more sensitive and the same exposure change produces a greater density difference. The gradient (slope) of the curve increases with increasing exposure ([Figure 6-17](#)). At very high values, the gradient may start to decrease; that is, the film again becomes less sensitive, however, this effect is not often encountered in industrial radiography, though common with medical film. The term used to refer to the gradient of the characteristic curve is “film contrast.”



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Figure 6-17. Typical Characteristic Curve

6.2.10.7.1 A characteristic curve provides information about speed, contrast (average gradient), and fog of X-ray film. The characteristic curve is significant because it demonstrates, within limits, that a dense film is more sensitive to small variations in exposure than a light film. Therefore, the dense film is better to show small changes in subject contrast due to discontinuities and geometric changes in the part. Characteristic curves can also be used to calculate exposure changes needed to optimize a technique when altering film type or desired density.

6.2.10.8 Film Speed. Film speed is a factor in determining the amount of radiation a film must receive to obtain a given density. Generally, film speed varies with film grain size. The larger grain film is faster and the smaller grain film is slower. While film speed is sometimes an important consideration for economy, normally the prime consideration is resolution of the details. High-speed films (e.g., films with low signal-to-noise ratios), SHOULD only be used when they are capable of meeting the resolution requirements of the inspection. Where high-detail resolution is required, the slower, higher signal-to-noise ratio films SHOULD be used without exception.

6.2.10.9 Film Contrast. Film contrast is a measure of the difference in film density due to exposure to different amounts of radiation. When exposed beneath a step wedge, a film with low contrast would show only minor changes in image density between one step and another. A high-contrast film, exposed under identical conditions would show sharp graduated changes in image density between steps. The efficiency with which the emulsion responds to an increment in exposure varies with the absolute value of the exposure. If a radiograph has high contrast, small differences in light transmission are high and readily discerned by the eye. Thus, the image will reveal small discontinuities in the subject. As a result, a dense image on the film makes small discontinuities on the specimen more visible. Image densities of 2.0 or more are usually recommended or required for high sensitivity to discontinuities in critical areas of parts. This will be discussed further in a later section. Film contrast SHOULD be distinguished carefully from subject contrast (a flat sheet specimen will give negligible contrast with any film). Subject contrast is affected by X-ray kilovoltage or gamma-ray characteristics. In summary, the overall image contrast with any given specimen will depend upon:

- Kilovoltage of the X-ray beam or characteristics of gamma radiation.
- Type of screens used.
- Image density.
- Processing conditions.
- Film contrast.

6.2.10.10 Film Latitude. The film latitude is the reverse of film contrast, the higher the contrast, the smaller the latitude, the lower the contrast, the greater the latitude. Latitude is, therefore, the range of radiation intensities a film is capable of recording. Latitude is also the term used to indicate the range of material thicknesses that can be visualized in the final image. Often in the radiography of castings or circular rods, where it is necessary to visualize a large range of thicknesses, wide latitude is desirable.

SECTION III RADIOGRAPHIC EQUIPMENT

6.3 RADIOGRAPHIC INSPECTION EQUIPMENT.

6.3.1 Types of X-ray Generators.

6.3.1.1 Tank Type Generators. Tank-type units are usually small and light in weight for ease of portability. The entire high voltage circuit is housed in a single housing, which is commonly known as the tube head in portable X-ray units. This arrangement avoids having to transmit high voltage from the high voltage transformer to the X-ray tube by means of insulated conductors. The housing contains the X-ray tube, the high voltage transformer, and the filament transformer. Electrical insulation is usually by transformer oil or compressed insulating gas. The control box is a separate unit that can be positioned at some remote distance to protect the operator from radiation. Different circuit designs are used in various tank-type generators.

6.3.1.2 Separate Component Generators. Separate component units are those units where the transformers are separated from the X-ray tube. The high voltage and filament connections are made between the transformers and the X-ray

tube through insulated cables. These units offer the advantage of ease of positioning the X-ray tube. The tube is contained in a protective housing with adequate insulation for the high voltages to be applied to the tube. These separate component units are usually fixed installations and parts to be inspected are transported to the X-ray equipment. Size or weight of this equipment is not of importance because they are usually intended for radiography in a shielded facility.

6.3.2 Types of X-ray Tubes.

6.3.2.1 Directional Tubes. In directional X-ray tubes, the anode is set at an angle to the electron beam. When the high-speed electrons strike the target, X-radiation is generated in a solid spherical pattern. The massive anode functions as an absorber for the radiation traveling into the anode. In most X-ray tubes, lead-absorbing materials are used to restrict the exiting radiation to a cone-shaped field passing through a window. The shielding reduces the leakage radiation hazard to personnel, and prevents additional scattered radiation from surrounding materials and areas. In some portable equipment, shielding of the X-ray tube has been omitted for the advantage of saving on weight. In some very high-energy units, such as beta-trons and linear accelerators, the target is comparatively thin and offers little absorption to the very high-energy radiation being generated. The radiation beam from the front of the target is shielded to provide a directional pattern, conical in shape.

6.3.2.2 Rod Anode X-ray Tubes. These tubes are designed to produce a radiation beam in a circular pattern. These tubes are used for circumferential radiography, particularly pipe welds. By use of an absorbing sleeve (usually lead), the circular radiation pattern can be reduced to a directional beam.

6.3.3 Considerations in Choosing Equipment.

6.3.3.1 Choice of Radiation Energy. The relation of X-ray voltage to the penetration for steel or other common materials depends upon the density of the material and the absorption characteristics of the material in the X-ray beam. For more information, [Table 6-4](#) can be used as a guide for applying X-rays to inspection problems, assuming average radiographic results are expected. It is necessary to establish lower limits as well as upper limits on material thickness because using voltages higher than required to penetrate a given thickness will reduce the radiographic contrast.

Table 6-4. Appropriate Radiation Energies for Radiography of Steel

Kilovoltage Range	Material Thickness
5-50 kV ¹	Extremely thin, such as foil up to 1/8 in.
50-150 kV	1/8 to 3/4 in. steel
100-200 kV	1/4 to 2 in. steel
200-400 kV	3/4 to 3 in. steel
1000 kV	1 to 5 in. steel
2000-6000 kV	2 to 8 in. steel
15-24 MeV	3 to 18 in. steel

¹ This energy range is also useful for composite structures. Note that for X-ray energies of 15 kV or less, scatter in the air path may be a problem.

6.3.3.2 Choice of Equipment. Equipment choice SHOULD depend upon the circumstance under which radiographic inspection is to be conducted and the technique requirements. Some factors are “tube head type,” “window,” and “focal spot size.”

6.3.3.2.1 Tube Type. The choice of a directional or a rod anode tube type SHOULD depend upon the type of radiographic inspection conducted. Circumferential specimens, such as pipe welds, are compatible with the rod anode radiation. The directional X-ray tubes restrict the radiation to a smaller area and have a comparatively smaller focal spot resulting in better quality radiographic images.

NOTE

The scattered radiation is greater with the rod anode and additional personnel protection is often necessary.

6.3.3.2.2 Window. When the X-ray absorption of a test object is low, lower energy radiation is required. To take advantage of the higher contrast provided at lower energies, an X-ray tube with a beryllium window SHOULD be used since beryllium transmits the low energy radiation. The beryllium window offers advantages up to 150 kV and, therefore, radiographic inspections requiring 150 kV or less SHALL use a beryllium window X-ray tube. A typical glass window SHOULD prove satisfactory for energies above 150 kV. The beryllium window and the resultant soft (low energy) spectrum SHALL also be used for the inspection of composite laminates. For example, a graphite-epoxy composite laminate 0.100- inch thick might require the use of X-ray energy in the order of 10-20 kV for optimum sensitivity. Reasonable exposures with standard portable X-ray equipment are often difficult below 25-30 kV. X-ray energies of 15 kV or less, the air between the source and object would scatter the X-rays. If the X-ray equipment will operate that low, one way to displace the air is to stuff a helium- filled plastic bag between source and object.

6.3.3.2.3 Focal Spot Size. X-ray tubes are available with different focal spot sizes. The focal spot in an X-ray tube is the area of the target that produces the primary X-ray energy (Figure 6-11). The actual size of the focal spot is determined by the electron bombardment pattern on the target. The minimum size of this area is limited by the melting point of the target material and the concentration of the bombarding electrons per unit area. Tungsten (W) is most often used as target material because of its high melting point of 6170°F and high efficiency of X-ray production. An effort is made in X-ray tube design to achieve the smallest possible focal spot consistent with voltage, current required, melting temperature of the target material, and the field coverage needed. The smaller the focal spot size, the sharper the radiographic image. It is normal to expect a focal spot size of 2 to 10 mm (millimeters) in the voltage range of 100 to 2,000 kV. For special applications, equipment with focal spots less than 1 mm in diameter is available. X-ray tubes with dual focal spots are often used so the operator can choose the focal spot size and operational conditions compatible with the demands of inspection quality. New X-ray machines are also available with focal spots called mini-focus (spot size in the range of 0.2 to 1 mm) and micro-focus (spot size in the range of 0.002 to 0.025 mm). These new small focal spot X-ray units provide excellent image sharpness and can also be used to enlarge the X-ray image geometrically.

6.3.3.3 Equipment Protective Devices. X-ray generators SHALL be not only safe to use, but also SHALL be protected against damage from inadvertent misuse. To accomplish this objective, X-ray equipment SHALL have protective devices as discussed in the following paragraphs.

6.3.3.3.1 Overload Thermal Circuit Breaker . The overload thermal circuit breaker (usually incorporated in the main line switch) provides protection to the equipment SHOULD a component failure be encountered. This protection assures the thermal circuit breaker will disconnect the unit from the power supply before extensive damage is done to the control box assembly or tube X-ray tube head.

6.3.3.3.2 Over-Voltage Protection Circuit . The over-voltage protection circuit works by either setting spark gaps to arc at the over-voltage point or by a voltage sensitive relay in the control circuit of the high voltage section. Sometimes both methods are used since it is possible under extreme conditions of surges, the over-voltage relay circuit MAY NOT react. This eliminates the possibilities of voltage damage due to operator carelessness or component failure.

6.3.3.3.3 Inverse Voltage Suppressor. There is also the possibility of inverse voltage damage in a high voltage X-ray circuit. This becomes a problem when the line voltage conditions vary widely (e.g., when using X-ray equipment in the lab on constant power or in the field on a portable generator). A circuit called the inverse voltage suppressor, consisting of a resistor and rectifier network in the primary winding of the transformer is used to protect X-ray equipment under these conditions.

6.3.3.3.4 Over-Current Fuse. An over-current fuse is used in the control circuit of the filament supply to prevent damage to the tube head due to incorrect usage of the equipment or component failure. The alternative is to design components in which the combination of variables will not result in damage to the unit. This is not desirable when attempting to achieve maximum utility in a design.

6.3.3.3.5 Over-Temperature Thermostat. To achieve the maximum safe working temperature of materials such as oil and solid insulation used in high voltage X-ray circuits, it is necessary to prevent over-temperature of the materials. To accomplish this, an over-temperature thermostat is installed in the X-ray tube head to prevent damage to those materials.

6.3.3.3.6 Flow Switches and Pressurestats . When using gas as insulation material, it is necessary to provide pressurestats in the X-ray tube head. Pressurestats prevent operation and consequent damage to the equipment SHOULD the gas pressure fall below the safe operating level for insulation of the high voltage parts. Flow switches and pressurestats in the oil and water circulators are also used to prevent operation of the X-ray unit when the unit is not being properly cooled. The type of protection provided in the unit will determine the degree of dependability of the equipment.

6.3.4 Considerations When Operating X-ray Equipment.

6.3.4.1 Effect of Focal Spot Size. The size of the focal spot bombarded by the electrons affects the heat dissipation capabilities of the anode. This limits the tube rating, or the milliamperes at which the tube MAY be safely operated. Additional effects are:

6.3.4.1.1 Heat Dissipation. The method of removing heat from the X-ray tube anode affects the tube ratings. An X-ray tube dependent upon convection cooling has a lower limit of operation than the same tube where water or some other coolant is used to conduct heat away from the focal spot.

6.3.4.1.2 Operational Considerations.

CAUTION

Follow manufacturer's guidance for warming up X-ray equipment. All X-ray tubes in the lab's inventory should be warmed up at least once every 30-days.

When a new X-ray tube is put into operation, it requires a warm-up period. A tube head, new or used may have been stored for a period of time, and a very small amount of gas may have been released into the vacuum by the metallic parts within the tube. These gases can be driven back into the metal components by operating the tube at a low kilovoltage and slowly heating the anode to high temperatures. Therefore, an X-ray tube head, which has not been operated for a specified period of time, SHALL be energized at a low kilovoltage, and the kilovoltage slowly increased until maximum rating has been obtained. The same procedure SHALL be used when a unit has not been operated for 30-days or more.

6.3.4.2 Component Substitution Rules. The Department of Defense has spent many thousands of dollars on repair, replacement, and shipping costs for X-ray equipment. The following information is a guide that will assist NDI personnel when troubleshooting X-ray equipment.

- a. The most likely cause of a system malfunction could be a defective tube head cable. The cable alone may be defective or the defective cable could damage other system components.
 - (1) The first step in troubleshooting X-ray equipment is to substitute a known-good tube head control cable with the malfunctioning equipment.

CAUTION

Never substitute a good control box or tube head without first doing this step because a bad cable may damage the known good system too.

- (2) If the system still does not work after substituting the good cable, do not then assume the original cable is good; set it aside.
- b. After ensuring a good cable is installed, the next component to substitute is a known-good tube head for the questionable one.
 - (1) When testing the system after substituting the known-good tube head, always start in the "Operate Mode" with a 0 kV and 0 mA on the set line. After pressing the "X-ray ON," advance the mA to 5.0 mA, and then the kV one kV at a time, the mA SHOULD be flowing at 5.0 mA by the time 25 kV is reached. Continue to advance the kV up to 100 kV. If no problems are encountered up to 100 kV, slowly warm the tube head up as if the tube head was not used for the previous 30-days. If problems occur at low kV, do not advance the kV.
 - (2) If no problems are noted, do not assume the original tube head is good or bad.

- c. If malfunctions still occur, substitute a good control box. Start in the “Operate Mode” and advance mA and kV as in Step b.1.
- d. The system SHOULD be operating properly now if all of the components used for substitution were good.
 - (1) Now check out the original tube head by putting it back on the system. Again start testing in the “Operate Mode” with 0 kV and 0 mA set on the control unit. After pressing the “X-ray ON,” advance the mA to 5 mA and the kV one kV at a time. The mA SHOULD be flowing at 5.0 mA when 25 kV is reached. If problems occur at low kV, do not advance the kV. Continue to advance the kV up to 100 kV.
 - (2) If no problems are encountered up to 100 kV, auto-warm the tube head as if the tube head had not been used for the previous 30-days.
- e. Continuity test the cables pin on one end, to corresponding pin on other end, and from each pin to all the other pins, and the shell on the same end of the cable. Always make sure cable connectors are fully inserted.

NOTE

A cable may be good lying in one position, but defective in another position. It is also possible to identify a bad cable by simply X-raying it with a good instrument. Broken wires are commonly found within one-foot from the end connectors.

6.3.4.3 Tube Head Rating. Several variables affect the maximum rating of an X-ray tube head. These SHALL be carefully observed to ensure the X-ray tube head rating is not exceeded. Some of the more important variables to be considered are listed below.

6.3.4.3.1 Focal Spot Size. The size of the focal spot dictates the milliamperes that can safely be conducted across the X-ray tube.

6.3.4.3.2 Method of Cooling. The method used to remove heat from the anode affects the length of time the tube head MAY be operated under a standard operating condition. The operation is extended by the use of external coolant.

6.3.4.3.3 Type of Circuit. The type of circuit design used in the X-ray generator affects the tube head rating. When self-rectified circuitry is used, the inverse voltage applied to the X-ray anode limits the operation of the tube head. Usually, the maximum operating conditions are much greater where full wave circuitry is used in comparison to self-rectified generators.

6.3.5 Standard Industrial X-ray Equipment in the DoD.

6.3.5.1 Spellman/Lorad LPX-160 Portable Industrial X-ray Unit. The LPX-160 is an air or water-cooled X-ray unit with an operating potential of up to 160 kV and a tube current of up to 5 milliamperes (mA). The tube head is insulated with sulfur hexafluoride gas, pressurized to 50 psig @ 70°F, is end grounded and has a 0.063-inch thick beryllium window (for beam filtration) located approximately 2-inches from the end of the tube. At 0.5-meter from the window, the dose rate in the primary beam is about 261 R/min (2.61 Sv/min) and 14.5 R/min (0.145 Sv/min), unfiltered and filtered respectively through 0.5- inches of aluminum. The unit has a cone shaped radiation field (full angle = 40°). Leakage radiation as measured one meter from the tube head, with the main beam being absorbed by 25 half-value layers of lead, ranged from 12.7 mR/hr (0.127 mSv/hr) to 385 mR/hr (3.85 mSv/hr). The measured half-value layer (HVL) of 0.41 inches corresponds to an average X-ray energy of about 83 keV.

6.3.5.2 Golden Engineering XR-200 Digital X-ray Unit. The Digital Radiograph System (DRS)TM model XR-200 is a pulsed X-ray unit manufactured by Science Application International Corporation. The DRS (or Golden Source as commonly referred to) contains an X-ray tube head that is air cooled and is manufactured by Golden Engineering. The tube operating potential is 150 kV and with a 0.5-milliamperes (mA) fixed current. The maximum output of the digital X-ray unit is 3 to 3.2 mrem/pulse (0.03 to 0.032 mSv/pulse) in the primary beam at 1-foot from the tube-head target. The unit can be set at 1 to 99 pulses. The pulse rate is 25 pulses-per-second with a pulse width of 50-nanoseconds.

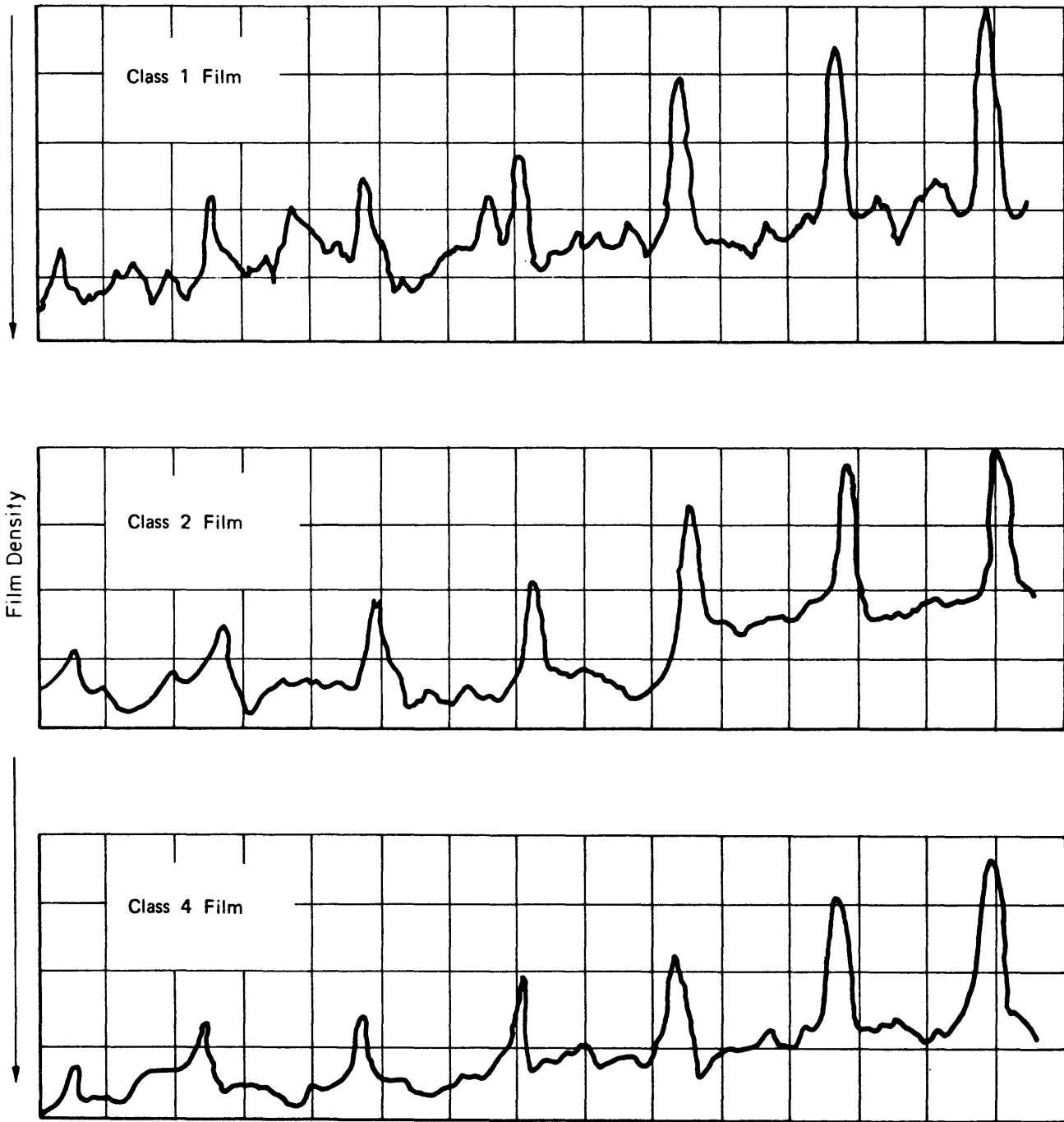
NOTE

The pulse rate can vary slightly according to the battery charge. The unit has a cone shaped radiation field (full angle = 40°).

6.3.6 Radiographic Film.

6.3.6.1 Classification of Radiographic Film.

6.3.6.1.1 Classification by Signal-to-Noise Ratio. The effect of signal-to-noise ratio caused by film grain size is shown with a microdensitometer trace across the radiographic images of a series of small wires made through one inch of aluminum ([Figure 6-18](#)). All exposure parameters were a constant except exposure time, which was varied to compensate for the three different film speeds. The ratios between the trace amplitudes for the wires and the respective backgrounds indicate the signal-to-noise ratios for Class 1, Class 2, and Class 4 radiographic films. Notice the higher frequency content of the Class 1 film, indicating its greater detail resolution capability.



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Figure 6-18. Microdensitometer Tracings of Images of DIN Wire Penetrameters (IQIs)

6.3.6.1.2 **Classification by Film Speed.** Another way to classify film is according to film speed. The approximate relative speeds of radiographic film exposed to radiation energy between 100 and 150 keV are as follows ([Table 6-5](#)).

Table 6-5. Relative Speeds of X-ray Films Exposed at 100 kV

Film Designation	Relative Film Speed ¹
Agfa	
D8	3.7
D7	2.7
D6R	1.5
D5	1.7
D4	1.0
D3	0.75
D3 (single coat)	0.28
D2	0.28
Kodak	
AA	3.1
T	2.07
B	2.0
M	1.0
R	0.4
R (single coat)	0.2
Fuji	
1X150	3.6
1X100	2.0
1X80	1.0
1X59	0.8
1X50	0.5
1X29	0.4
1X25	0.36

¹ Film speed numbers should be compared only within a single manufacturer.

6.3.6.2 **Classes of Radiographic Film.** Film is available that varies in signal-to-noise ratio, speed of response to radiation, and graininess. It is most appropriate to classify X-ray film in relation to the signal-to-noise ratios. Very fine-grain films with a very high signal-to-noise ratio require comparatively large quantities of radiation for exposure and produce images with excellent resolution of detail. In the choice of a particular film, a trade-off must be made between resolution and speed of exposure. The criticality of an inspection will determine this tradeoff. Some commonly used X-ray films are classified as follows:

- **Class 1:** This class has the highest signal-to-noise ratio and includes such films as: Agfa D2, Kodak Type R, and Fuji IX 25. These are considered high detail resolution films and SHOULD be employed when the most sensitive radiograph is desired.
- **Class 2:** This class is considered as high in signal-to-noise ratio and includes such films as: Agfa D4, Kodak Type M, and Fuji IX 50.
- **Class 3:** These films have a moderate signal-to-noise ratio and include: Agfa D5, Kodak Type T, and Fuji IX 59 with screen.
- **Class 4:** These high-speed films, by comparison, are considered to have a low signal-to-noise ratio and include: Agfa D7, Kodak Type AA, and Fuji IX 100.

6.3.6.2.1 The previous classifications differ from others because they are based upon signal-to-noise ratio rather than film speed. We show a bar chart (Figure 6-19) reflecting the relationships of signal-to-noise ratios, film speed, and detail resolution capabilities of different film classes. We also have a more detailed guide to film classification (Table 6-6 and Table 6-7). These tables are not inclusive of all film types or manufacturers which MAY be authorized for use, since manufacturers introduce new films or take existing films off the market from time to time. Specific inspection instructions MAY specify film other than what is listed. Each manufacturer has a particular designation for films. Small variations may be noted in film speed and contrast of the films made by the different manufacturers within a particular class.

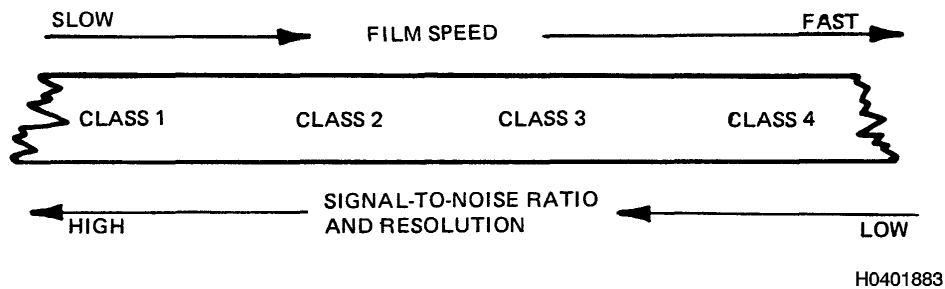


Figure 6-19. Relationship Between Signal-to-Noise Ratios and Speeds of Film

NOTE

The following classifications are based on film system rather than signal-to-noise ratio. The film plus the associated film-processing requirements are based according to the criteria established by the manufacturers of the film and processing chemicals. The classifications previously listed in this manual approximately corresponds to the new film system classifications, as follows:

- Class 1 is considered equivalent to ASTM Class Special
- Class 2 is considered equivalent to ASTM Class I
- Class 3 is considered equivalent to ASTM Class II
- Class 4 is considered equivalent to ASTM Class III
- Exceptions include films followed by an arrow; they are the equivalent of one class higher in the new system classification compared to the previous classification.

Table 6-6. Film Classes

Manufacturer	System Class			
	Special	I	II	III
Agfa	D2	D3 D4 D5	D7 (á)	D8
Fuji	IX25	IX 20 IX 50 IX 80	IX 100	IX 150
Kodak	DR	M MX 125 T	AA400 (á)	CX

The following table includes the ISO speed and signal-to-noise ratio for each film type.

Table 6-7. Speed and Signal-to-Noise Ratio

Mftr	Class											
	Special			I			II			III		
	Type	Speed	S/N	Type	Speed	S/N	Type	Speed	S/N	Type	Speed	S/N
Agfa	D2	40	371	D3	64	294	D7(á)	320	142	D8	400	114
				D4	100	232						
				D5(á)	200	169						
Fuji	IX25	50		IX 20	25		IX 100	320		IX 150	500	
				IX 50	100							
				IX 80	200							
Kodak	DR	32	378	M	80	320	AA400(á)	320	140	CX	400	124
				MX	125	220						
				125								
				T(á)	200	209						

6.3.6.3 Storage of Unexposed Film.



Any films in containers sealed by the manufacturer and not opened SHALL be stored with the film on edge to avoid container damage and possible film damage. Storage temperature should be between 40 and 75°F (4 and 24°C) at a relative humidity range of 30 to 60%. When storage temperatures exceed 90°F (32°C) for 30 days or more, a fog test SHALL be performed with a limit of 0.30 density units total for base density. Regardless of storage temperatures, films SHALL be allowed to stabilize at room temperature before opening containers.

X-ray film is sensitive to the cosmic radiation that exists everywhere. This radiation will cause fogging. Fog is the darkening of the radiograph by scattered radiation, exposure to light, or pre-exposure to radiation. It can also be caused by over-development or aging. It SHOULD be noted fog brings no information to the film and merely creates a high background that reduces contrast and image visibility. The very high-speed films, being more sensitive to exposure, are more susceptible to fogging than the slower emulsions.

6.3.6.4 Film Expiration Date. The expiration date is marked on the film box at the time of manufacture. To prevent exceeding the expiration date, film SHOULD be ordered in quantities, so long-term storage is not necessary. The inventory of film SHOULD be rotated to use the older film first. Film that exceeds its “shelf life” date SHOULD NOT be put in salvage, the usability will be verified by: 1) processing an unexposed sheet to determine clearing and fog level, the density should not exceed 0.30, 2) if the clearing and fog level are satisfactory, make a radiograph of a step-wedge and penetrameters (IQIs) to determine the sensitivity and contrast of the film in question, a 1.4% sensitivity (2-1T) is recommended, 3) if these limits are acceptable, extend the shelf life by six months and continue using the film. Document the verification results on a DD Form 2477. At the end of the extended period reverify the film using the aforementioned procedure. (Navy and Marine Corps Only) If the film does not meet acceptable quality levels use the film for training, for clearing the automatic film processor, for detection of foreign objects, or if the quantity is so great to warrant, ship the film to NAVAL AIR Technical Training Center (NATTC) ATTN: NDI School, 230 Chevalier Field AVE, Pensacola, FL 32508. If the film is one-year past its original shelf life, the film SHALL NOT be used for crack detection and SHALL be utilized for one of the alternate purposes mentioned earlier. X-ray films present no greater fire hazard in storage in the X-ray laboratory and filing room than an equal quantity of paper records. There is no necessity for expensive vaults equipped with elaborate fire protection devices. Film storage area SHALL be kept clean.

NOTE

CR System software text SHALL NOT be used in lieu of lead identification materials when labeling images. Unless otherwise specified, all labeling must be captured in the raw image.

6.3.6.5 Film/Image Identification Methods. To properly apply information obtained through radiography, the material inspected must also be accurately identified with respect to the object radiographed. In the absence of engineering direction in a specific weapons system technical order, the required method of film/image identification is lead numbers and letters, lead tape, or lead labels. The Laboratory Supervisor can approve use of film perforation methods for their specific laboratory. The required identification information SHALL be: Aircraft tail numbers or part name/serial number if not an aircraft item, DDMMYY or julian date, inspection procedure, shot number, employee number of radiographer-in-charge, and organization. The inspection procedure may be abbreviated or shortened but must be clearly understood. The organization should include the wing designation number and the laboratory office symbol (e.g., 36 MXMFN). When film/imaging plate size does not allow identification on the film, the information will be typed onto the image by adding text with the system's software for CR, or it will be placed in an acceptable film file pouch and the information typed or written legibly on the film file. When the X-ray film interpreter is not the radiographer-in-charge the interpreter's employee number will be typed onto the image by adding text with the system's software for CR, or written on the X-ray film with an appropriate marker (e.g., grease pencil) or on the film pouch when film size is an issue.

6.3.7 Film Holders, Film Cassettes, and Radiographic Screens.

NOTE

Due to interaction between film and lead screens, film SHALL NOT be left in cassettes or film holders more than 24-hours.

Film holders and film cassettes are used to protect the film from light exposure while the film is being transported and while it is being exposed. These film holders are of various designs made to hold the various film sizes. Screens increase the imaging radiation partially from electrons emitted from the lead screen and by secondary radiation from the lead screen.

6.3.7.1 Film Holders.

6.3.7.1.1 Flexible Film Holders. Flexible film holders are used where it is necessary to contour the film to achieve good film-to-test-object contact, however, sharp bends SHOULD be avoided. These holders are made of a lightproof flexible material. Lead screens with a rubber or vinyl backing are available to permit contouring and flexible positioning of the film for exposure.

6.3.7.1.2 Cardboard Film Holders. Cardboard film holders are used extensively in industrial radiography. They are simply a heavy, kraft paper envelope between hinged cardboard covers. The back has a lead foil lining to absorb back-scattered radiation. Always place the holder with the "tube side" mark toward the tube head or radiation source. If the holder position is reversed, the radiation is filtered by the lead foil backing and will result in images of lower density. The cardboard holders are economical and durable. Lead screens can be inserted into the envelope with the film for making lead screen radiographs. Intimate film-screen contact is normally accomplished by placing the object to be inspected on the cardboard holder.

6.3.7.1.3 Rigid Film Holders/Film Cassettes . The term cassette is usually applied to rigid film holders. Cassettes have a "bakelite" or "magnesium" front to allow transmission of X-rays. The back contains a lead foil lining to absorb the back-scattered radiation. Cassettes are normally used with calcium tungstate or lead screens. Cassettes provide uniform compression on the film and screens to assure good physical contact between the film and screen for ultimate image sharpness. Cassettes are comparatively heavy and somewhat difficult to handle.

6.3.7.2 Vacuum Cassettes. Vacuum cassettes are especially useful when utilized in conjunction with lead or fluorescent screens. The air is pumped out of the cassette, ensuring intimate film-screen contact. They are very flexible, allowing the film to be positioned in a confined space.

6.3.7.3 Using Film Holders and Film Cassettes. Film cassettes give better film-to-screen contact and are often used without a screen. Lead screens can be used with film holders, but care SHALL be taken to maintain even film-to-screen contact. In any critical exposure, the use of cassettes are recommended. Film holders are generally used to radiograph thin sections of materials at low kilovoltage, 150 kV or lower. The sensitivity is reduced when using film holders on thick sections due to backscatter. Using film holders with a lead sheet backing will reduce the backscatter. At lower than 30 kV, standard film holders cannot be used because the cardboard will show on the radiograph. For lower kilovoltage, holders can be made from vinyl or Mylar materials. A lead sheet can be taped to the back to reduce backscatter. Film holders can be taped in place or secured in any way that will not affect the radiograph adversely.

6.3.7.4 Labeling Film Holders and Film Cassettes. Ballpoint pen or other sharply pointed writing instrument SHALL NOT be used to write information on the surface of any cassette or film holder. Film artifacts may be produced which will affect radiographic interpretation. If identification is required use marking techniques, that the necessary information can be recorded on before applying to the cassette.

6.3.7.5 Bending or Kinking Film Holders/Cassettes. Care SHALL be taken not to bend or kink film holders unless absolutely necessary for placement of film for exposures. Artifacts may be produced, which could impair interpretation of the radiograph. An alternative includes the use of smaller or custom shaped film for better fit to part, if required.

6.3.7.6 Preparation of Film Holders/Cassettes.

CAUTION

Loading of film cassettes and film holders SHALL be accomplished under safe light.

- a. Remove all unnecessary materials from the workspace.
- b. Before loading the film cassette/holder, open it and examine for cleanliness and light leaks. Discard any film holders physically damaged beyond repair. Some light leaks MAY be repaired with black photographic tape. Remove any lint or dust with a clean cloth. Dust SHALL NOT be blown out since moisture may lodge on the holder and be transferred to the film.
- c. Place the film, film cassette/holder, and if used, screens in a convenient location in the darkroom to simplify loading of the film cassette/holder.
- d. If a screen is used, place it in the film holder face upwards so it will contact the film.

6.3.7.7 Loading the Film Holder/Cassette.

NOTE

Film SHALL NOT be allowed to slide into the cassette/holder pocket. Scratches from the cassette/holder or screen may result.

The procedure that follows covers only one type of film holder. Film holders vary in methods of locking and opening but the same procedure will apply except for these details.

- a. Open the inner folded cover all the way.
- b. Withdraw the film from the film box with paper cover in place. Handle the film only at the edges with light finger pressure.
- c. Grasp one side of the paper cover to open it. Place the film so the free end is against the rear edge of the holder. Lower the film slowly and allow the film to fall gently into the holder and remove the paper.
- d. Refold the inner paper cover.
- e. Close the holder cover taking care the lead screen on the cover enters the holder pocket without binding. Some holders MAY NOT have a lead screen on the cover. In this case, when the use of the screen is desired, place it in the holder pocket face down.
- f. Lower the holders cover and fasten the locking device. If the holder has a spring back, turn the latch to lock the holder.

6.3.7.8 Prepackaged Film. X-ray film suppliers offer X-ray film in prepackaged, flexible envelopes or in rolls. The prepackaged film eliminates the film loading operation in the darkroom. Packaged film is available, double-loaded with films

of differing speeds, or placed between two intensifying screens incorporated in the package. This film is convenient to use and is preferred for many industrial applications. Prepackaged film is the most widely used film due to its convenience for field inspection.

6.3.7.9 Radiographic Intensifying Screens.

6.3.7.9.1 Purpose of Radiographic Screens. X- and gamma radiation has such a great penetrating power that less than 1-percent of the energy is absorbed when striking film. Materials that emit less penetrating radiation in the form of secondary electrons or fluorescent light utilize the emitted radiation more fully. A radiographic intensifying screen is a layer of material that intensifies the imaging radiation being impinged on the film, decreasing the scatter radiation reaching the film. In industrial radiography, these are often used in direct contact with the X-ray film. There are three types of screens used to intensify an image: lead, fluorescent, and fluorometallic.

6.3.7.9.2 Types of Radiographic Screens.

6.3.7.9.2.1 Lead Screens. Certain materials emit electrons when struck by high energy X-rays or gamma rays; these electrons are called secondary electrons. X-ray film is not only sensitive to light, but to these secondary electrons. The material of choice is lead foil usually 0.001-inch to 0.040-inch thick, bonded to a flexible support. Lead screens in direct contact with film have two effects:

- **Intensify Incident Radiation.** Incident radiation with energies above 88 keV eject photoelectrons from the atoms of the lead. These photoelectrons act on the emulsion in the same way as the primary radiation beam.
- **Improve Clarity.** They improve clarity by absorbing scattered radiation of longer wavelengths.

6.3.7.9.2.1.1 When to Use Lead Screens. Lead screens SHOULD be used whenever they improve radiographic quality. Because of the resulting improvement, they are generally preferred to calcium tungstate screens. Whenever there is a need to perform a radiographic inspection using a combination of screens and film, they SHALL be of the same plane dimensions and in close contact with each other during exposure.

6.3.7.9.2.1.2 Selection of Lead Screens. Lead screens are available in various thicknesses and SHOULD be chosen relative to the radiation energy being used. The energy level threshold for lead screens is approximately 100 kV. Any secondary electrons generated below this level have little effect towards intensification. Above 100 kV, the general rule for lead screen selection is: For 100 - 400 kV, use a front screen of 0.001 to 0.005-inch and a back screen between 0.005 to 0.010-inches. For isotopes (Iridium 192 and Cobalt 60), use a front screen of 0.005 to 0.010-inch and a 0.010-inch back screen. Supervoltages above 1.0 MeV require a front screen of 0.010 to 0.060-inch and a back screen between 0.010 to 0.040-inches. When used properly, they intensify the image by improving the image contrast and final radiographic sensitivity. Sample results are shown in [Table 6-8](#) however, the quality of the image is improved at all kV settings.

Table 6-8. Sample Result

Source Power	Relative Exposure Times for Equivalent Density Under Standard Conditions	
	Without Screens	With Lead Screens
120 kV	1.0	1.0
150 kV	1.0	0.7
200 kV	1.0	0.5
Iridium 192	1.0	0.25
Cobalt 60	1.0	0.50

NOTE

The results were obtained with a 0.004-inch front screen and a 0.006-inch back screen.

CAUTION

Hydrogen peroxide or other common cleaning agents SHALL NOT be used for this purpose because their chemical composition will cause fogging of the sensitive film emulsions.

6.3.7.9.2.1.3 Care of Lead Screens. X-ray screens are given a special waterproof protection coating to both sides. Due to the high electron absorption in light materials and the intensifying action on lead foil screens caused by the electrons emitted under radiographic excitation, the surface SHALL be kept free from dust, dirt, and lint. These conditions will produce light densities on the radiograph. Sensitive surfaces of the screens SHALL NOT be touched because fingerprints may show up and interfere with accurate interpretation on the radiograph. If cleaning of the surface is required, wash with mild soap and water and dry thoroughly with a soft cloth. Remove grease and lint from the surface of lead foil screens with a solvent such as Isopropyl Alcohol. If more thorough cleaning is necessary, rub screens gently with the finest grade of steel wool. Film may be fogged if left between lead screens longer than is reasonably necessary, particularly under conditions of high temperature and humidity. When screens have been freshly cleaned with an abrasive, this effect will be increased. It is best to delay the use of freshly cleaned screens at least 24-hours.

6.3.7.9.2.1.4 Precautions When Using Lead Screens . Lead screens SHALL be used with great care. Common problems are:

- A fuzzy image resulting from lack of intimate contact between the screens and film.
- Dark lines on the image resulting from scratches on the screens.

6.3.7.9.2.2 Fluorescent Screens. Some materials fluorescence (emit light) when struck by X- or gamma radiation. Each fluorescent material normally referred to as phosphor, has its own fluorescent light spectral region. Intensification factors of 5 to 200 can be obtained by appropriate choice of phosphors relative to the spectral sensitivity of X-ray film. Due to the visible light dispersion from phosphor crystals to radiographic film, fluorescent screens render images less sharp than those obtained with direct exposure. Fluorescent screens produce radiographic images of inferior quality; therefore they are used selectively in industrial radiography for applications where they are allowed by code, and where the desired image quality requirements are met. For this reason, their use is normally limited to those situations where exposure speed is more important than image quality, or where the radiation quantity available is inadequate to perform the task. Fluorescent screens consist of a phosphor like calcium tungstate coated on a flexible support. Whenever there is a need to perform a radiographic inspection using a combination of screens and film, they SHALL be of the same plane dimensions and in close contact with each other during exposure.

6.3.7.9.2.2.1 Care of Fluorescent Screens. Fluorescent light from intensifying screens obeys all of the laws of visible light, and cannot pass through opaque bodies as X-rays do. Make every effort to keep the screens clean. To avoid extraneous shadows caused by absorption of the fluorescent light by foreign matter during exposure, dust and dirt particles SHALL NOT be allowed to collect between the film and screen surfaces. Stains upon the screens SHALL also be avoided. Calcium tungstate screens MAY be stored in the processing room but away from chemicals and other sources of contamination.

6.3.7.9.2.3 Fluorometallic Screens. Fluorometallic screens consist of calcium tungstate phosphor coated on lead foil, which in turn is coated on a suitable, flexible support. When used in appropriate applications, the combination of fluorescent phosphor and lead foil, results in substantial intensification with radiographic images having improved contrast. Intensification factors ranging from 5 to 30 can be obtained when these screens are exposed with appropriate industrial X-ray films, while factors of 30 to 150 can be realized when the screens are used with medical type films.

6.3.8 Quality Indicators.

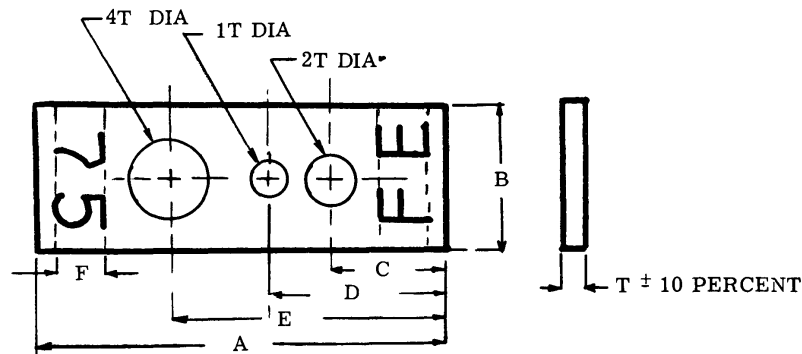
6.3.8.1 Image Quality Indicators (IQI)/Penetrameters.

NOTE

Use of IQIs are specified within a given technique. If the IQI identified in the technique is not available, consult with the appropriate Air Logistics Center's NDI Level III for instructions. IQIs SHALL be used during crack detection inspections unless it is documented that for a given exposure, adequate sensitivity is achievable without IQIs and can be achieved with reasonable changes of exposure values. IQI use is not limited to technique such as film or nonfilm (i.e. computed radiography).

Image quality indicators (IQI) or penetrameters are devices whose image is used on a radiograph to determine radiographic quality level (sensitivity). They are not intended for use in judging the size of, or in establishing acceptance limits of discontinuities. Instead, they are used to determine the acceptance level for the particular radiographic technique used to make the radiograph. The IQI is a test piece whose composition is similar to the material of the subject being tested. It generally is located in an appropriate location on, or adjacent to, the subject being radiographed. When it is specified by code, technical data or when it is not practical to place the IQI on the subject, the IQI is located adjacent to the subject on a rectangular block of material similar to the IQI and having a thickness close to the subject.

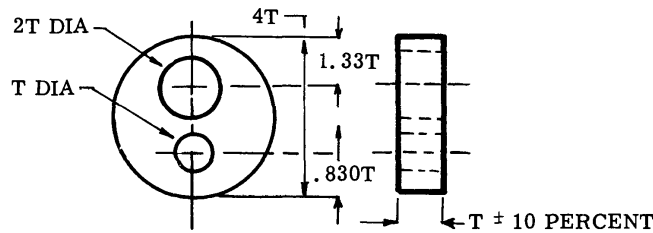
6.3.8.2 Description of Image Quality Indicators (IQI)/Penetrameters). A wide range of IQIs are specified for use by various industries. Wire IQIs are particularly useful for weld inspection. A common form of IQI is the hole-type, a small plaque, fabricated of the same or similar radiographic density material being radiographed. Hole-type IQIs are furnished in material groups allowing use on alloyed materials with a primary constituent such as aluminum. The thickness of the IQI is a known percent of the test object thickness, usually 2-percent. Holes in the IQI are of diameters 1T, 2T, and 4T, where the T equals IQI thickness. For thinner IQIs, the 1, 2, and 4T holes and IQI thickness are fixed minimum values that do not represent 2-percent thickness of the specimen. Visualization of these holes can be related to the sensitivity of the radiographic image. A typical IQI described in ASTM E1742 (MIL-STD-453) is shown in [Figure 6-20](#).



T	INCREMENTS	A	B	C	D	E	F
.005-.020 INCL.	.0025	2.000	.500	.520	.800	1.150	.250
.025-.050 INCL.	.005	2.000	.500	.520	.800	1.150	.250
.060-.160 INCL.	.010	2.850	1.000	.800	1.250	1.900	.375

MIN PENETRATOR THICKNESS .005 ± 10 PERCENT
 MIN DIAMETER FOR 1T HOLE .010 ± 10 PERCENT
 MIN DIAMETER FOR 2T HOLE .020 ± 10 PERCENT
 MIN DIAMETER FOR 4T HOLE .040 ± 10 PERCENT

DESIGN FOR PENETRATOR THICKNESSES UP TO AND INCLUDING 0.160



DESIGN FOR PENETRATOR THICKNESSES OF 0.180 AND OVER MADE IN .020 INCREMENTS

SYMBOL	MATERIALS (SEE 4.2.2.2.3)
SS	STAINLESS STEEL
AL	ALUMINUM
FE	STEEL
MG	MAGNESIUM
CU	COPPER
TI	TITANIUM

ALL DIMENSIONS IN INCHES.
 HOLES SHALL BE TRUE AND NORMAL TO THE SURFACE OF THE PENETRATOR. DO NOT CHAMFER.
 TOLERANCES ON PENETRATOR THICKNESSES AND HOLE DIAMETERS SHALL BE ± 10 PERCENT
 OR 1/2 OF THE THICKNESS INCREMENT BETWEEN PENETRATOR SIZES, WHICHEVER IS SMALLER.

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Figure 6-20. ASTM E1742 (MIL-STD-453) IQI Information

6.3.8.2.1 The ASTM E1025 (MIL-STD-453) IQI has lead numbers permanently attached to the plaque that indicates the material thickness (T) of the specimen. In [Figure 6-20](#), the thickness identification (ID) number indicates the IQI is for use on a 0.750- inch thick specimen. The thickness of the IQI is normally 2-percent of the specimen thickness. Therefore the IQI with an ID of 1.0 (1-inch thick material) would be 0.020-inch thick. Except in special instances, IQIs less than 0.005-inch in thickness are not available, therefore, in normal operation, the 0.005-inch IQI is used on test objects when the thickness MAY be 0.25-inch or less. The use of IQIs is discussed further in [Paragraph 6.4.4](#).

6.3.8.3 **Wire IQI.** Wire IQIs consist of six wires of various diameters encapsulated in a plastic pouch. Like hole-type IQIs, wire IQIs are furnished by material group. Sensitivity levels are not as obvious as hole-type IQIs. A sensitivity level is stated in a procedure, or the sensitivity equivalent to a hole-type IQI thickness/hole number can be found in ASTM E747, or calculated using a formula in the same document. For example, a hole-type IQI for a 1-inch thick specimen with 2-percent (2-2T) sensitivity would use a 0.015-inch diameter wire for equivalent sensitivity. Wire IQIs are easily placed directly on the specimen, and in the case of welds, shim blocks are not required since the wire IQI is placed over the weld. Wire IQIs are not subject to hole distortion when placed off-axis to the X-ray beam. [Table 6-9](#) provides a list of wire IQI sets and wire diameters.

Table 6-9. Wire IQI Sizes and Identification Numbers

Set A		Set B	
Wire Diameter (inch)	Wire Identification	Wire Diameter (inch)	Wire Identification
0.0032	1	0.010	6
0.004	2	0.013	7
0.005	3	0.016	8
0.0063	4	0.020	9
0.008	5	0.025	10
0.010	6	0.032	11

6.3.8.4 **Representative IQI.** An alternative to the hole type or wire type IQI is a representative IQI (RQI). An RQI is typically a special item or items designed for revealing specific discontinuities or representation of same expected in actual parts with a particular radiographic system. Actual flawed parts may be used for RQIs. RQIs unlike IQIs may not be required to show in each radiographic image, only to determine adequate sensitivity for each exposure set-up or as a daily system check. RQIs shall be developed or approved by a Level 3 and specific use shall be established in applicable technical data.

6.3.9 Radiation Monitoring Devices and Instruments.

6.3.9.1 **Monitoring Devices.** Optically Stimulated Luminescence (OSL) Dosimeters are the primary dosimetry device and have generally replaced Thermoluminescent Dosimeters (TLD) and film badges as the legal record of radiation exposure in the Air Force. An additional instant readout style dosimeter is used by NDI personnel along with the primary dosimetry device. The Electronic Personal Dosimeter (EPD) is approved and calibrated by the USAF School of Aerospace Medicine (USAFSAM/OEA) and SHALL be used for standard X-ray operations. Dosimeters other than the Thermo Fisher Scientific Mark 2 (MK2) and Trudose BG EPD Models SHALL be approved by the AF NDI Office and USAFSAM. Exception: NDI personnel utilizing pulsed X-ray technology shall utilize a pocket ion chamber dosimeter. For more safety-related information, see [Chapter 6, Section VIII](#) for Air Force.

NOTE

- Except in cases of emergency, dosimeters SHALL NOT be submitted to be read until replacement dosimeters have been received.
- The OSL Dosimeter provided through USAFSAM and Bioenvironmental Engineering is the most common in the Air Force; for this reason, throughout [Chapter 6](#) (especially [Chapter 6, Section VIII](#)) the term "OSL" is used to represent the primary dosimetry device. The EPD and pocket ion chamber instant readout style dosimeters will be identified as appropriate to the application of radiography discussed.

6.3.9.1.1 Primary Dosimetry Devices.

6.3.9.1.1.1 Optically Stimulated Luminescence (OSL) Dosimeters.

6.3.9.1.1.2 Theory of Operation. Optically stimulated luminescence (OSL) is a process in which a preirradiated (exposed to ionizing radiation) material when subjected to an appropriate optical stimulation, emits a light signal proportional to the absorbed dose. This methodology can be employed in personnel dosimetry to determine the “dose of record” for X-ray and gamma radiation.

6.3.9.1.1.3 Materials suitable for OSL are similar to those used in thermoluminescent dosimeters (TLD), i.e., they are crystalline solids. The only difference is the manner in which the electrons are freed from their traps and unlike a TLD, OSL dosimeters can be reread multiple times. Radiation energy deposited in the material promotes electrons from the valence band to the conduction band. These electrons move to traps in the band gap. The greater the radiation energy absorbed (dose), the greater the number of trapped electrons. When it is time to assess the dose, the trapped electrons are freed by exposing the dosimeter to light. When the electrons are freed, they fall to a lower energy level and emit light photons. The intensity of the emitted light is measured and used to calculate the dose. Not all the electrons are freed from their traps. If the light output from the OSL dosimeter is analyzed over a short period of time, many electrons will remain trapped. This means that the dosimeter can be reread many times without a significant loss of signal.

6.3.9.1.1.4 The Control Device (OSL). A dosimeter that measures the background radiation accumulated during the transit and storage of personnel dosimeters. Control dosimeters are managed in accordance with DAFMAN 48-125 by the Installation Radiation Safety Officer (IRSO). One control is required per installation, however if the IRSO requests to add a control to a specific area this can be done through USAFSAM via the Radiation Dosimetry Web. The following guidelines apply when a radiography area has a control dosimeter issued:

- a. The control device SHALL be stored in the same area as the personnel OSL dosimeters, away from sources of radiation in a temperature and humidity controlled area. The control device SHALL NOT be removed from this area.
- b. The control device SHALL NOT be worn by any individual.

6.3.9.1.1.5 Dosimetry Services (OSL). Dosimetry service for Air Force installations is provided by USAFSAM/OEHHD, 365 Third Street Bldg 674-C, Wright-Patterson AFB, OH 45433, through the Installation Radiation Safety Officer (IRSO), in accordance with the provisions of DAFMAN 48-125, *Personnel Ionizing Radiation Dosimetry*. Bioenvironmental Engineering is responsible for the dosimeter program at base level and will receive all routine reports issued by the USAFSAM/OEHHD. The IRSO SHALL investigate all dose reports which exceed predetermined action levels, and ensures all records of radiation dosage are properly maintained for each individual on the program.

NOTE

For government contractors, or government contractor-hired subcontractor employees, dosimetry services may not be provided by the Air Force, except as otherwise specified in the applicable government contract. Contracted dosimetry services should provide monitoring devices that are equivalent to the OSL or TLD as appropriate.

6.3.9.1.1.6 Thermoluminescent Dosimeter (TLD).

6.3.9.1.1.7 Theory of Operation. TLDs are well suited for personnel and environmental monitoring of X-ray and gamma radiation. TLDs are special materials which, when exposed to ionizing radiation, results in raising the electrons of the detector material to temporary higher energy states. When these materials are later heated, the electrons fall back to their normal energy states and in the process emit light. The amount of light emitted is directly related to the amount of radiation dose the TLD received. By measuring this light, the dose received by the individual wearing the dosimeter can be assessed. Although a number of materials can be used as TLDs, “lithium fluoride,” “lithium borate,” and “calcium sulfate” are the most common material used for personnel dosimetry.

6.3.9.1.1.8 The Control Device (TLD). To accurately measure personnel dose, each radiography area will have at least one device designated as a “Control Device” (TLD). It is used to measure radiation exposure received by personnel monitoring devices (primarily from naturally occurring background radiation) while badges are in storage and transit.

- a. The control device SHALL be stored in the same area as the personnel TLD, away from sources of radiation in a temperature and humidity controlled area. The control device SHALL NOT be removed from this area.
- b. The control device SHALL NOT be worn by any individual.

6.3.9.1.2 Instant Readout Style Dosimeters.

CAUTION

Each Electronic Personal Dosimeter (EPD) SHALL:

- Be checked to ensure that alarm functions (sounds) prior to use.
- Be used with the infrared interface (IR Reader) and associated software.
- Be set to give alarm signals at preset dose rate of not more than 500mR/hr (5 mSv/hr).
- Require special means to change the preset alarm function.

NOTE

Calibration of EPDs SHALL be scheduled so sufficient quantities remain on hand to support continuing radiography operations.

6.3.9.1.2.1 Electronic Personal Dosimeter (EPD). Although approved in ANSI-N13.11 as a dosimeter of record in lieu of a OSL dosimeter, the EPD is currently used within DoD for instant readout of dose and dose rate. It measures gamma and X-ray radiation over the range of 20 keV to 6 MeV and beta radiation from 250 keV to 1.5 MeV, and it provides readout of both skin (7 mg/cm²) and deep dose equivalent (1000 mg/cm²). The readout provides a dose equivalent range of 0.1 to 1000 rem. The radiation is detected by three silicon diode detectors, which save data to secure memory every few minutes and provide visible and audible alarms if either the accumulated dose or dose rates exceed specified levels. Doses SHOULD be checked periodically throughout the day when performing radiography and SHALL be recorded in the dosimetry log at the beginning and end of each operation for future comparison with OSL dosimeter results. When EPDs are submitted for calibration long-term dose memory is reset to zero. They are worn in the same manner as OSL dosimeters.

6.3.9.1.2.2 The Thermo Fisher Scientific EPD (MK2 & Trudose BG) is a direct reading electronic dosimeter that is sensitive to X-ray, γ (gamma) radiation, and β (beta) particles. The Air Force Personnel Ionizing Radiation Dosimetry Program uses this dosimeter solely to detect and measure exposures to high energy photon γ radiation. The principal application of this dosimeter is in support of emergency response operations and Nondestructive Inspection (NDI). The EPD detects radiation by use of multiple diode detectors, giving direct readout of dose equivalents Hp(10) (deep/whole body) and Hp(07)(shallow/skin) in units of Sv and rem. Display range is auto ranging from 0 mrem to >1600 rem. Dose rate display ranges from 0 to 400 rem/hour auto ranging, with resolution to the 2 most significant digits. The dosimeter is linear to $\pm 10\%$ at dose rates <50 rem/hour; $\pm 20\%$ from 50 - 100 rem/hr; $\pm 30\%$ from 100 -200 rem/hr; and $\pm 50\%$ from 200 - 400 rem/hour. Energy response relative to Cs-137 is certified by the manufacturer to be linear to $\pm 50\%$ from 15 - 17 keV; $\pm 20\%$ from 17 keV -1.5MeV; $\pm 30\%$ from 1.5 MeV - 6 MeV; and $\pm 50\%$ from 6 MeV to 10 MeV. Dosimeter accuracy is certified by the manufacturer to be $\pm 10\%$ for Cs-137. The dosimeter includes a number of audible and visual alarms for dose, dose rate, and other parameters that are user configurable via an infrared interface and associated software.

6.3.9.1.2.3 Pocket Ion Chamber Dosimeters. For industrial radiography utilizing pulsed X-ray equipment, the use of pocket ion chamber dosimeters is mandatory. The dosimeter is generally of the size and shape of a fountain pen. The dosimeter contains a small ionization chamber with a volume of approximately two milliliters. Inside the ionization chamber is a central wire anode, and attached to this wire anode is a metal coated quartz fiber. When the anode is charged to a positive potential, the charge is distributed between the wire anode and quartz fiber. Electrostatic repulsion deflects the quartz fiber, and the greater the charge, the greater the deflection of the quartz fiber. Radiation incident on the chamber produces ionization inside the active volume of the chamber. The electrons produced by ionization are attracted to, and collected by, the positively charged central anode. This collection of electrons reduces the net positive charge and allows the quartz fiber to return in the direction of the original position. The amount of movement is directly proportional to the amount of ionization which occurs. By pointing the instrument at a light source, the position of the fiber may be observed through a system of built-in lenses. The fiber is viewed on a translucent scale which is graduated in units of exposure. Typical industrial radiography pocket dosimeters have a full scale reading of 200 milliroentgens but there are designs that will record higher amounts.

NOTE

Calibration of pocket ion chamber dosimeters SHALL be scheduled so sufficient quantities remain on hand to support continuing radiography operations. Each dosimeter SHALL be calibrated in accordance with specific equipment technical data

6.3.9.2 Survey Instruments. Radiation exposure, at the energies used for industrial radiography, is most accurately measured with ionization chamber type survey instruments. These detectors use an air filled chamber across which an electric field is applied. When X-ray or gamma radiation interacts with the air in the chamber, it creates positive and negative ions that drift apart under the influence of the electric field. As the ions are collected on the electrodes within the chamber, a small current is generated which is measured by the instrument and directly related to the radiation exposure rate in air. For additional safety-related information, see [Chapter 6, Section VIII](#) for Air Force.

6.3.9.2.1 Characteristics. Radiation exposure measurement instrumentation SHALL have a range suitable for the conditions of use. Accordingly, all survey instruments used for industrial radiography "SHALL be capable of measuring a range from 2 mrem/hr (0.02 mSv/hr) through 1 rem/hr (0.01 Sv/hr), as a minimum" (10 CFR 34.25).

6.3.9.2.2 Environmental Interference. Portable survey instruments are affected by such factors as ambient temperature, configuration of radiation source (e.g., round, square, rectangular, etc.), isotope source, atmospheric pressure and relative humidity, direction of radiation beam, radiation quality (effective energy or radiation spectra), and instrument susceptibility to radio frequency radiation (RFR). Instrument response variations due to temperature and pressure usually do not exceed $\pm 5\%$ for survey instruments. Instrument directional dependence is negligible when the instrument's sensitive volume is pointed in the direction of the radiation origin. Instrument susceptibility to RFR MAY significantly affect ionizing radiation measurements in the presence of RFR. If RFR interference is suspected, it can often be confirmed by placing a piece of leaded (Pb) rubber or similar shielding material over the ionization chamber of the instrument to filter out the gamma or X-ray, while observing the instrument reading. If no change is noticed in the instrument response when the lead is placed over the chamber, the previous instrument response can be primarily attributed to RFR interference.

6.3.9.2.3 Survey Meter Response to a Spectrum of Energies. An X-ray machine operating at a given tube potential (kV), produces a spectrum of X-ray energies. Since industrial X-ray machines do not contain primary beam filtration (except the X-ray tube window), the X-ray spectrum contains a relatively large portion of low energy X-rays (below 50 keV) regardless of the tube potential (kV) setting employed. Therefore, it is important that the survey instrument used in determining the exposure rate produced by such X-ray machines be energy independent or, in other words, capable of accurately measuring the exposure rate over a wide range of X-ray energies.

6.3.9.2.4 Descriptions and Operating Characteristics of Specific Instruments.

NOTE

The Nuclear Research Corporation SM-400 end cap contains a lever-operated alpha check source to verify instrument operation each time it is used.

6.3.9.2.4.1 Survey meters meeting the requirement specified in [Paragraph 6.3.9.2](#) are authorized for NDI radiographic operations.

6.3.9.2.5 Recommended Instruments. The Nuclear Research Corporation SM400 is the primary on the Allowance Standard (AS) 455, the Fluke Biomedical (formerly Victoreen) 451P is noted as the replacement for the SM400 in the Defense Property Accountability System (DPAS), which is no longer in production. A survey meter (Ion chamber) which meets the specifications in [Paragraph 6.3.9.2](#), is considered "equivalent" to both recommended instruments discussed. Questions regarding the procurement of survey meters may be directed to the AF NDI Office, in consultation with the local Bioenvironmental Engineering Section. For additional safety-related information, see [Chapter 6, Section VIII](#) for Air Force.

6.3.9.2.6 Test Measurement and Diagnostic Equipment (TMDE) Calibration Requirements. Radiation survey meters SHALL be calibrated at intervals determined by AFMETCAL and/or as listed in TO 33K-1-100-WA-1.

6.3.9.2.6.1 Handling and Use of Radiation Survey Instruments.

6.3.9.2.6.1.1 Handling Survey Meters. Survey meters are delicate instruments, therefore, they SHALL be handled with care. Most survey instruments are not waterproof and SHALL be protected from wet weather conditions. If it rains when working outdoors, a clear, plastic bag will have no appreciable effect on radiation monitoring capability and will not hamper the operating of the control switches. If the components of the survey meter become wet, the instrument MAY have to be serviced and recalibrated. When survey meters are transported in vehicles, they SHOULD be placed in the driver's compartment with adequate support and restraint to prevent damage during transit.

6.3.9.2.7 Guidelines For Use.

NOTE

The zero will continually shift on some survey meters; personnel using these meters SHALL continually recheck the zero control and adjust the meter as necessary.

- a. Whenever radiographic operations are performed, at least one calibrated and operable radiation survey instrument SHALL be available at shielded installations. For unshielded installations/locations, calibrated and operable radiation survey instruments SHALL be available for immediate use for all personnel. The instrument(s) SHALL be turned ON and used as specified or demonstrated in the current, IRSO-approved Radiation Protection Survey and operating procedures during all radiographic operations. The instrument(s) SHALL have an adequate instrument response for the range of radiation energies encountered. When entering the area after deactivation of the radiation source, radiographers SHALL use a suitable, calibrated survey meter to assure the source has returned to its "off" position and that X-rays are no longer being produced.
- b. Due to the response time of electrical components, survey meters will not instantly indicate the maximum exposure rate. Typically, survey meters have a response time ranging from 2 to 15-seconds, with longer response times being required for lower dose rates. Therefore, prior to use, turn survey meters on for several minutes, and allow to stabilize. Thus, in order to accurately measure the actual dose rate present, the operator must hold the survey meter in a set position for a period of time longer than the specified response time. Survey meter response times are published in the instrument instruction manual.

6.3.10 Radiographic Processing Equipment. Radiographic processing involves two basic modes, "manual" and "automatic" processing. A third mode, "digital" will be discussed later.

6.3.10.1 Manual Processing. In the case of manual processing, chemistry is placed in tanks of a suitable material. Films are affixed to corrosion resistant metal hangers, which are submerged in the chemistry during processing. Chemistry temperature needs to be controlled, and in some instances, is accomplished with an incoming water mixing valve. A separate electrical dryer unit is generally employed to dry the processed film.

6.3.10.2 Automatic Processor. Automatic dry-to-dry machine processing is in wide use today because it affords increased processing stability and results in significantly shorter total processing time. Most automatic processors incorporate mutually or simultaneously driven transport rollers. All of the rollers in the four processing stages of development, fix, wash, and dry are driven at the same speed and therefore turn together as the film is being transported between them.

6.3.10.2.1 Various sub-assemblies incorporated in automatic processors include developer, and in some instances fixer temperature control units, a dryer heater fan, and automatic chemistry replenishment pumps.

6.3.10.2.2 Maintenance of Automatic Processors . Periodic inspection, maintenance, and lubrication of radiographic film processing equipment is required by the technical manual governing its operation. It is imperative the prescribed daily, bi-weekly, and monthly requirements be strictly followed to ensure proper operation of equipment and to support quality radiographic inspection results. With appropriate maintenance, automatic processors SHOULD give reliable and repeatable service for long periods of time.

6.3.11 Film Evaluation Equipment.

6.3.11.1 Densitometer. Measurement of radiographic density SHALL be done with electronic direct-reading type densitometers. The electronic direct-reading type densitometer is more accurate than the visual type. This densitometer SHALL

be capable of measuring the light transmitted through a radiograph with a film density up to 4.0 with a density unit resolution of 0.02. When film densities greater than 4.0 are required to perform a radiographic inspection a densitometer applicable to film densities up to maximum density is necessary.

6.3.11.1.1 Film Density Reference Strip. A photographic or radiographic-calibrated reference density strip, traceable to the National Institute of Standards and Technology (NIST), SHALL be used to calibrate the densitometer prior to determining the density of a radiograph. These calibrated density strips SHALL be replaced whenever they are physically damaged (e.g., scratched, crimped, or become wet by any fluid) to such an extent it may influence their effectiveness or when expired.

6.3.11.2 Illuminators/Viewers. For information see [Paragraph 6.5.10.6](#).

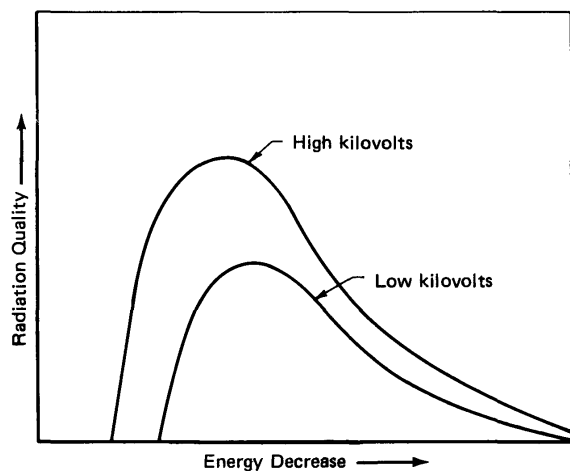
SECTION IV APPLICATION OF RADIOGRAPHIC INSPECTION

6.4 EFFECTIVE RADIOGRAPHIC INSPECTIONS.

6.4.1 Introduction. This section describes the factors that determine whether or not a particular radiographic inspection is sufficiently sensitive to detect small defects. Sensitive radiography requires maximum subject contrast resulting from correct kilovoltage; alignment of the beam with the plane of the likely flaw; a sharp image, due to good geometry and secondary radiation; and finally, optimum density to give good film contrast. Each of these factors is described in turn and a description is given of quantitative transformations to allow exposure and density changes with a minimum of experimentation.

6.4.2 Factors Affecting Image Quality.

6.4.2.1 Radiation Energy. The radiation energy chosen must be compatible with absorption rate of the subject. For low-absorbing subjects, low-energy radiation produces radiographic images with good contrast. Conversely, for inspection of thick, highly absorbing subjects, the radiation must be capable of sufficient penetration to produce an image within a reasonable period of time. To achieve a high-contrast, 96 to 99-percent of the incident radiation SHOULD be absorbed by the subject. Increasing kilovoltage reduces contrast because the quantity of radiation at any given energy increases and, perhaps more importantly, the proportion of radiation with a short wavelength (high energy) increases disproportionately. These two relationships are in [Figure 6-21](#). High energy radiation can penetrate the subject more easily, thus, reduces subject contrast. The effect on the final image of low or high contrast is shown ([Figure 6-22](#)). The right diagram in [Figure 6-22](#) shows for a given subject, a doubling of kilovoltage increases transmitted radiation 15 to 30 times. This example shows the disproportionate effect a small kilovoltage change can have upon a particular inspection.



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Figure 6-21. Effect of Kilovoltage on Transmitted Radiation Output

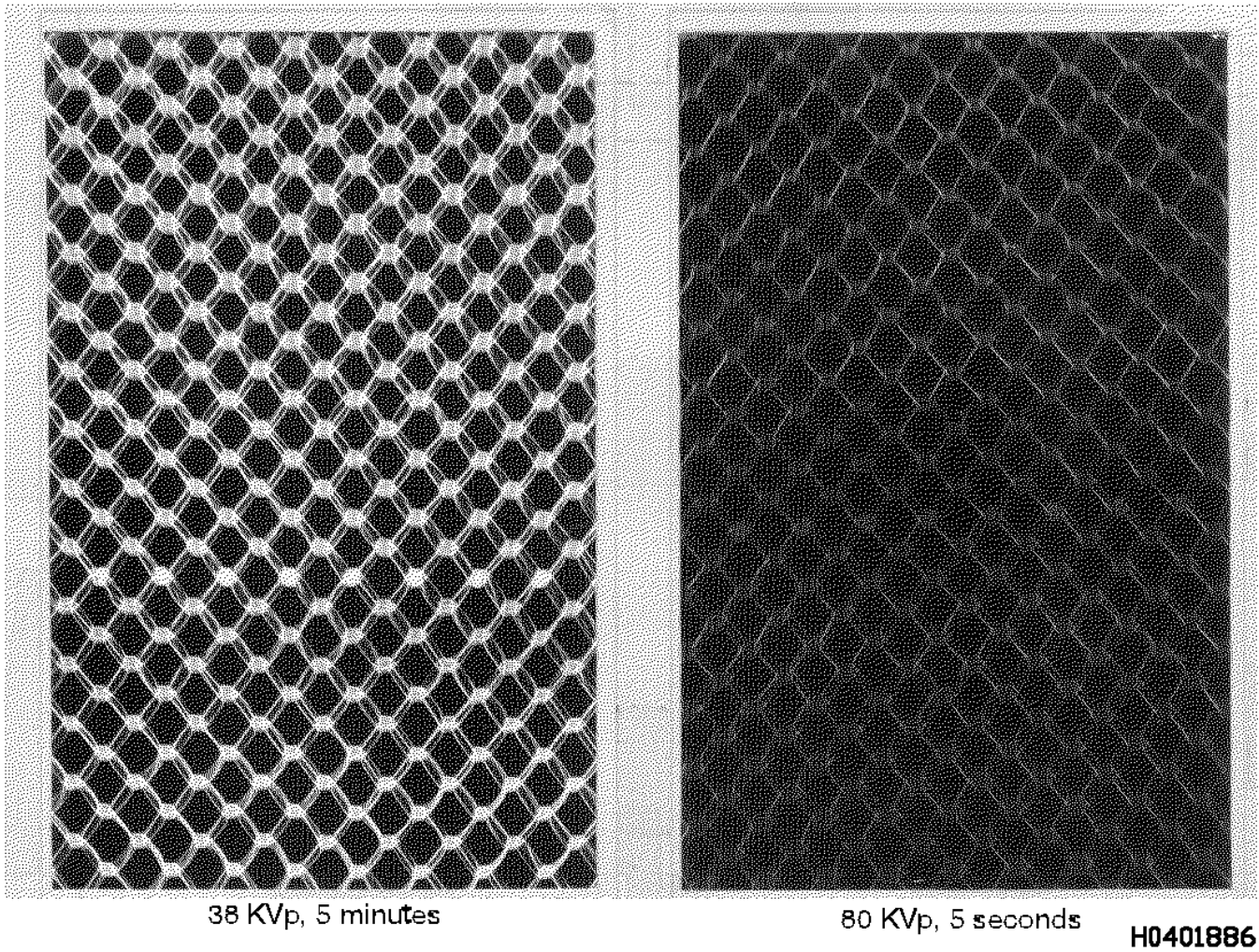


Figure 6-22. Radiographs of Honeycomb Showing Effect of Kilovoltage on Contrast

6.4.2.1.1 If industrial radiographic applications were to use monochromatic radiation, and if there was no scattering to be considered, the radiation absorption could be mathematically calculated with high precision using the classical attenuation equation, however, in normal applications, it is not possible to calculate the right kilovoltage to be used for a particular inspection because this optimum condition does not exist. The best initial approach is to use past experience. Approximate radiation energies compatible with various subjects is indicated in [Table 6-10](#).

Table 6-10. Approximate Radiation Energies Compatible With Various Absorbers

Radiation Source, kV	Aluminum or Other Light Metals	Steel
2-25	0.001-0.11 in.	0.001-0.01
25-50	0.1-0.75 in.	0.01-0.125
50-150	0.5-3 in.	0.125-0.75
100-250	2-8	0.125-1.75
150-400	3-12	0.375-3 in.
Iridium-192		0.625-4 in.
Cesium-137		0.75-4 in.
1 MeV		1.5-5 in
Cobalt-60		1.5-7 in
24 MeV		16 - 19 in.

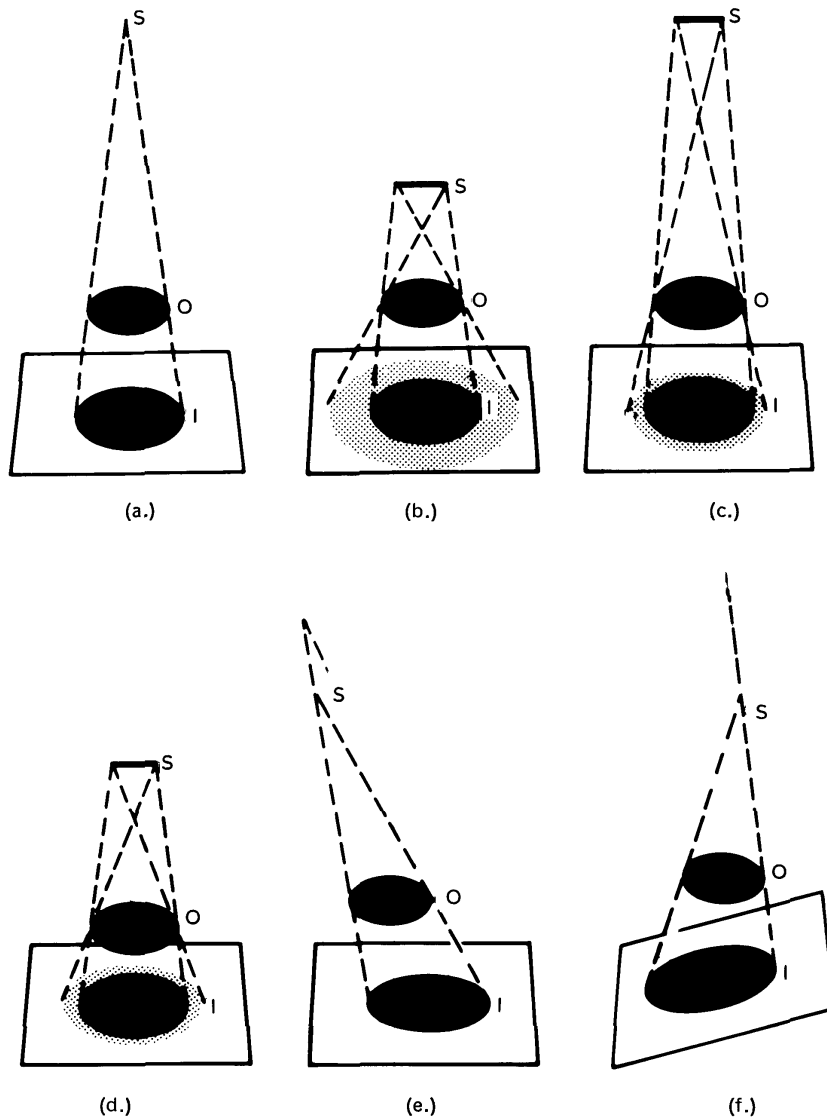
6.4.2.1.2 It SHOULD be noted, as radiation energy increases, the differences between absorbing materials become less pronounced than at lower energies. Due to photoelectric absorption, the atomic number of an absorber has a large effect upon radiation absorption at energies of 100 kV or less. At high energies, in the 1 MeV range, the material density becomes the major controlling factor in determining radiation absorption. A 10-percent change in radiation energy has a very definite effect at low energies. In MeV energy ranges, this same percent change in energy can hardly be detected in transmission characteristics

6.4.2.2 Radiation Quantity. An alteration in the filament current (mA) produces a direct change in the quantity of radiation emitted, but has no effect upon the radiation energy. Additionally, filament current (mA) and time are usually interchangeable. That is, the product of milliamperage and time is constant for the same photographic effect. This is known as the “reciprocity law.” This law is valid for X- and gamma ray exposures, with or without lead screens, and over the range of radiation intensities and exposure times used in industrial radiography. There is one exception, which is the use of fluorescent screens, discussed in [Paragraph 6.3.7.9](#). For very low or high intensities, the reciprocity law fails because of changes in the efficiency of the response of the film emulsion to unit radiation. If high production radiography is required, a source with a high radiation output would be economical. Usually, the high-output equipment requires a source with a comparatively large focal spot therefore, rate of radiation output is often directly related to focal spot size. The resulting unsharpness due to geometry can become detrimental to image quality.

6.4.2.3 Exposure Geometry. The geometrical setup used to produce a radiographic image is an important factor that contributes to final image quality. Geometrical relationships affect the image sharpness and help control image distortion.

6.4.2.4 Image Distortion. For the best radiograph, the source beam SHOULD be aligned perpendicular to the part and the film SHOULD be located on the same plane as the part. This positioning projects the image of the part upon the film in the true shape of the object with minimal distortion. Any deviation from these relative positions of source, object, and film will produce an image with some degree of distortion. This alignment is particularly critical for crack detection. Since discontinuities revealed in radiographic images are usually identified by their shape, images free of distortion are very important in interpretation. Where complex structures are encountered in aircraft inspection, it is often impossible to locate the various parts in the most desirable positions, and sometimes an inspection MAY be facilitated by planned distortions. Interpretation of distorted images is not impossible, but the film reader must mentally visualize the geometry of the object under evaluation, and how the exposure would project the distorted image onto the film. This ability requires practice and experience.

6.4.2.5 Image Unsharpness. This is the term applied recognizing there will always be unsharpness of the image to some degree, and perfect image sharpness is unattainable. The amount of geometric image unsharpness is due to size of the source of radiation and relative distances as shown in [Figure 6-23](#). The distance on the film over which an edge is spread is known as the penumbral shadow or the geometrical unsharpness, U_g . The value of U_g does not enter into other computations; it sets the upper limit for Ft/d . The value must be determined experimentally. The equation to determine unsharpness is located in [Paragraph 6.7.8](#).

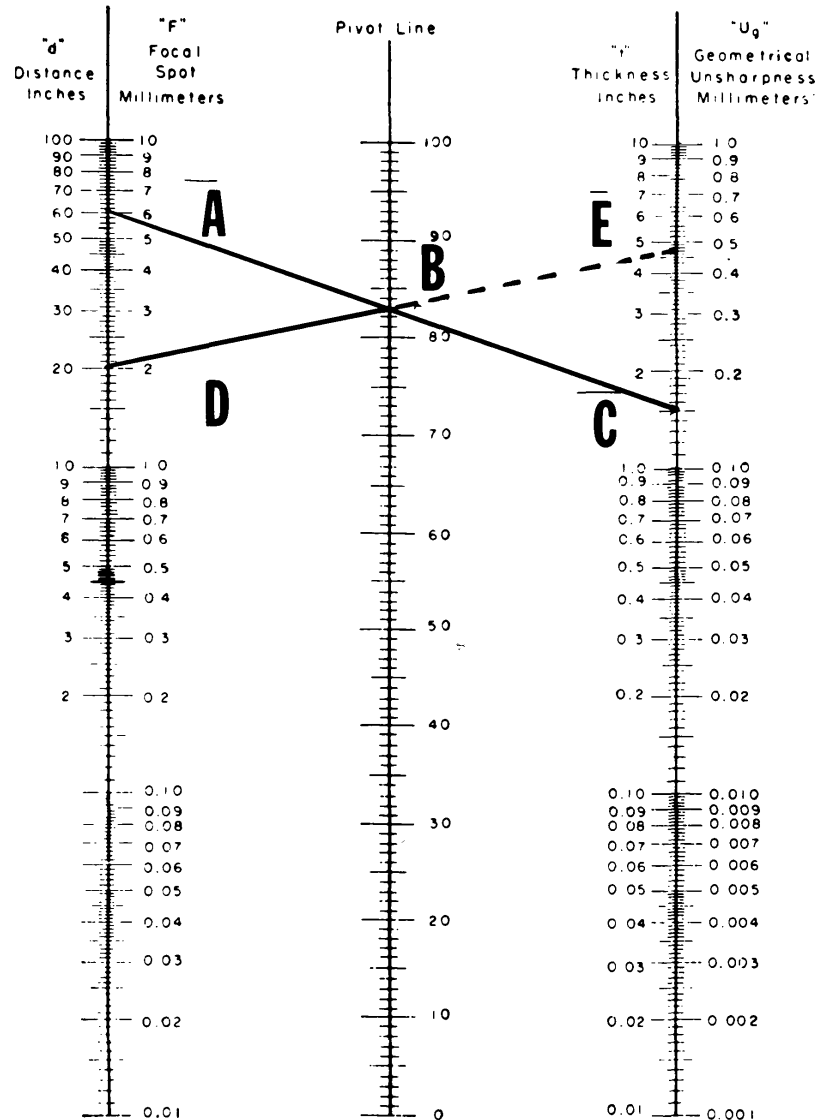


S REPRESENTS THE SOURCE, O REPRESENTS THE OBJECT BEING RADIOGRAPHED, AND I IS THE IMAGE PLANE. (a) OPTIMUM GEOMETRIC FIDELITY CONDITION. (b) EFFECT OF POOR F/d RATIO WITH LARGE PENUMBRA SHADOW, (c) CONDITION IMPROVED BY INCREASING SOURCE-TO-OBJECT DISTANCE. (d) SAME CONDITION ACHIEVED BY DECREASING PART THICKNESS OR DISTANCE FROM OBJECT TO FILM. (e) AND (f) ILLUSTRATE THE EFFECT OF GEOMETRICAL MISALIGNMENT.

H0401887

Figure 6-23. Possible Geometric Distortions

6.4.2.5.1 In considering geometrical unsharpness, recognize the value of new microfocus X-ray sources and the potential for geometric magnification. A nomogram is used to assist in solving this equation for various geometrical conditions (Figure 6-24). Note that 3 out of 4 terms in the equation must be known before it can be used.



H0401888

Figure 6-24. Nomogram to Assist in Solving Equation $U_g = Ft/d$

6.4.2.5.2 Suppose a specimen having a maximum thickness of 1.5-inches (t) is to be radiographed at 20-inch source-to-film distance (SFD) (d) using a source of effective focal size 6mm. The need is to establish an approximate value for U_g . The steps in using the nomogram are:

- Plot the points A and C that represent the known value of F and t. The pivot line is intersected at B.
- Plot a line joining point D (the value of d) and B. The extension of this line at E gives the value of U_g (0.47mm).

6.4.2.5.3 Remember unsharpness of the radiographic image is also affected by the characteristics of the X-ray film. Therefore, the total image sharpness MAY be controlled by either “geometrical unsharpness” or “film unsharpness.” The greater

of these two values will control the total unsharpness of the image. In any given situation, the geometric unsharpness, which can be tolerated most, will set the lower limit for the adjustable parameter. Additional demands on image sharpness are paid for in intensity of the image. Image unsharpness is inversely proportional to the source-to-object distance, whereas the intensity is inversely proportional to the square of this distance. Therefore, the trade-off of intensity for sharpness is not an equitable one. In many cases, this uneven exchange is necessary because it is very important to achieve good geometric definition. The basic principles of shadow formation SHALL be given primary consideration to ensure satisfactory sharpness and low distortion of radiographic images. Distortion cannot be entirely eliminated since some of the test object may be further away from the film than other parts, and radiation from all sources cannot be made ideally parallel; images will always be less than perfect. In summary, five general rules can be stated which promote quality assurance from geometric considerations.

- a. Use as small a focal spot as possible, as the considerations will allow.
- b. The distance between the source and the object SHOULD be as great as practical.
- c. The film SHOULD be as close as possible to the object being radiographed.
- d. Central beam SHOULD be as near to perpendicular with the film as possible.
- e. As far as the shape will allow, planes within the specimen plane of interest SHOULD be parallel with the film.

6.4.2.6 Film Placement. After the film and film holder have been chosen, consideration SHALL be given to the position of the film in relation to the part. In radiography of small parts, this could be a simple matter of laying the part on the film. With complex structures involved, film positioning is not quite as simple. A few rules can be of assistance in such inspection situations:

- a. Always position the film as close as possible to the area of interest.
- b. Attempt to locate the film so the plane of the area of interest and the film are perpendicular to the radiation beam. This is to prevent distortion in the final image.

6.4.2.6.1 When positioning the film, care SHALL be used to prevent sharp bends in the film or applying pressures to the film holder that can produce pressure marks or crimp marks (artifacts) on the final image. In radiography of curved surfaces, the source and film SHOULD be positioned, if possible, to take the best advantage of the inverse square law and to prevent as much distortion as possible. Flexible film holders SHOULD be used in order to place the film as near as possible to the surface of the test object. It may be noted in [Figure 6-25](#) the distance from source to the entire surface of the film is nearly constant and the thickness of the test object is also a constant to the path of radiation. This preferred positioning is not always possible, but it SHOULD be used when practical.

NOTE

The part undergoing inspection will always be between the source and the film.

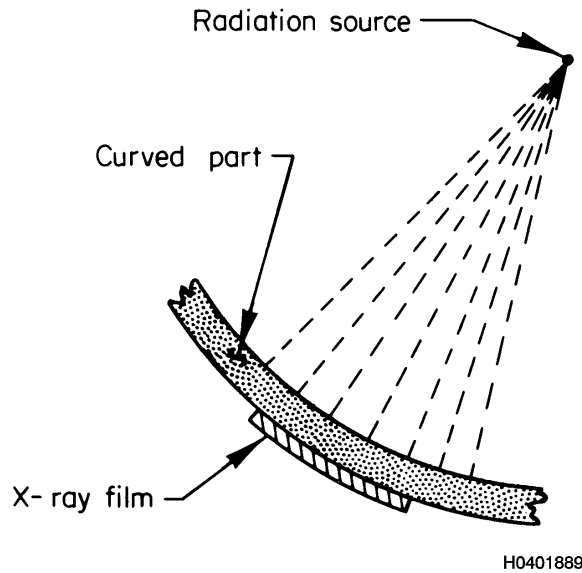


Figure 6-25. Preferred Geometry for Radiography of Curved Surfaces

6.4.2.7 **Focal Spot Size.** The ideal focal spot would have a pinpoint source of radiation. Though microfocus tubes approach this ideal, in actual practice this is impossible. Radiation sources have finite dimensions. The actual focal spot size in an X-ray tube is the projected area being bombarded by electrons from the heated filament; in gamma radiography, it is the radioactive pellet. To reduce the apparent size, the X-ray target is positioned at a small angle, and from the position of the X-ray film, this area appears as the projection of this focal spot on the film plane. This projection is referred to as the effective focal spot. Focal spot sizes must increase with increasing kilovoltage rating to prevent melting of the target material. Radiation is being emitted from the entire area of the effective focal spot. This radiation is projected at different angles through the test object and spreads the image of a sharp edge over a finite distance on the film. Examples of the formation of shadow projections are shown (Figure 6-23). What has been said about focal spot size in X-ray tubes also applies to gamma radiography where the pellet of radioactive material functions as the focal spot. The relatively large size of the pellets accounts for the inferior definition obtained with gamma radiographs.

6.4.2.8 **Source-to-Film Distance (SFD).** The sharpest image would be formed by having a SFD so great that the radiation would be parallel at the film plane (Figure 6-23). However, since radiation intensity or quantity is diminished in relationship to the inverse square of the distance, the radiation quantity available to expose the film would be very small, and exposure times would become impractical. Due to this, economics and practicability must be considered when producing a radiographic image. It is recommended the longest practical SFD be used for critical exposures to improve image sharpness. If the source-to-film distance is changed, the formula (Paragraph 6.7.4) can be used to correct the exposure. Because an increase in distance causes a decrease in beam intensity, only the intensity is changed. The kilovoltage SHALL NOT be changed when correcting for SFD changes.

6.4.2.9 **Inverse Square Law.** When the X-ray tube output is held constant, or when a particular radioactive source is used, the radiation intensity reaching the specimen is governed by the distance between the tube (source) and the specimen, varying inversely with the square of this distance. The explanation below is in terms of X-rays and visible light, but applies with equal force to gamma rays as well. Since X-rays conform to the laws of light, they diverge when they are emitted from the anode and cover an increasing larger area with lessened intensity as they travel from their source. This principle is illustrated by Figure 6-26.

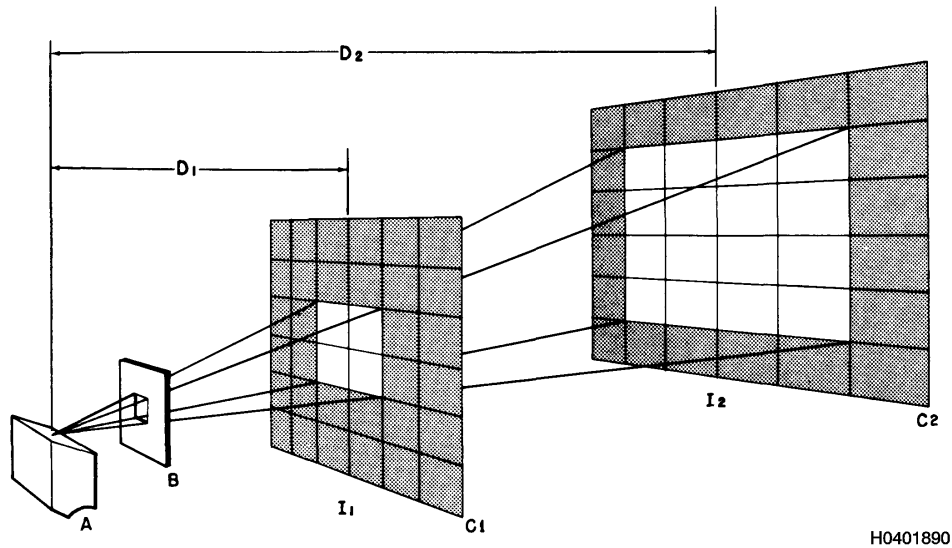


Figure 6-26. Inverse Square Law Diagram

6.4.2.9.1 In this example, it is assumed the intensity of the X-rays emitted at the anode (A) remains constant, and the X-rays passing through the aperture (B), cover a 4-square-inch area upon reaching and recording surface (C1), which is 12-inches (D_1) from (A). If the recording surface (C1) is moved 12-inches farther from the anode to (C2), so the distance between (A) and (C2) is 24-inches (D_2) or twice the distance between (A) and (C1); the X-rays will cover 16-square-inches, an area four-times as great as at (C1). Therefore, the radiation-per-square-inch on the surface at (C2) is only one-quarter that at (C1). Thus the exposure that would be adequate at (C1) must be increased four-times in order to produce a radiograph at (C2) of equal density. In practice, this is done by increasing either the time, or milliamperage. Mathematically the inverse square law is expressed as follows: (Paragraph 6.7.3).

$$\frac{I_1}{I_2} = \frac{(D_2)^2}{(D_1)^2}$$

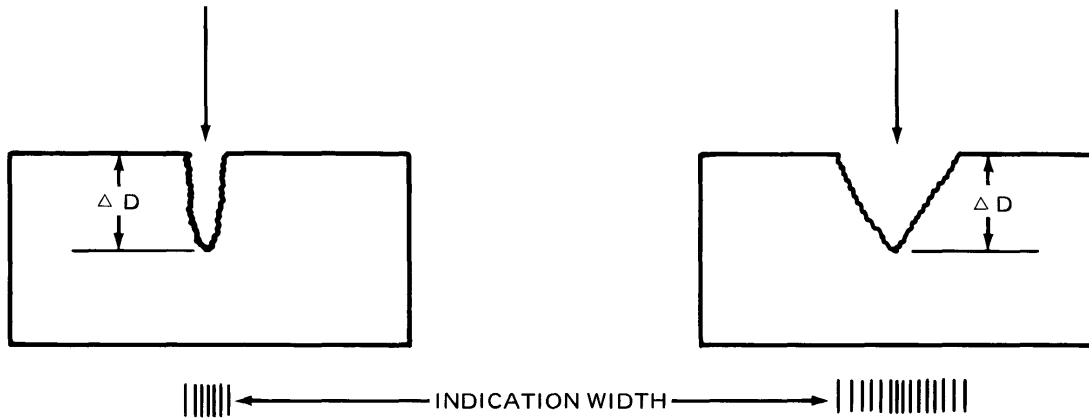
where I_1 and I_2 are the intensities at distances D_1 and D_2 respectively.

Example: An intensity of 2 mR/hr was measured at 40-inches from the source. What would be the intensity reading at 30-inches, and at 20-inches? Do not forget to take the square of the predetermined value for D_2 when determining unknown distances.

6.4.2.10 **Source/Defect Orientation.** Radiography can be used quite reliably to detect cracks, provided certain stringent criterion is met. It is very easy to produce an apparently high quality radiograph that does not show an existing crack, or with a crack indication so faint it can barely be seen. The primary factor in the case of crack detection is alignment, however contrast, spatial resolution, and noise are also critical. Also, the crack itself needs to have sufficient depth in relation to the total thickness of the cross-section being evaluated. As crack length increases, crack width tends to increase which improves detection.

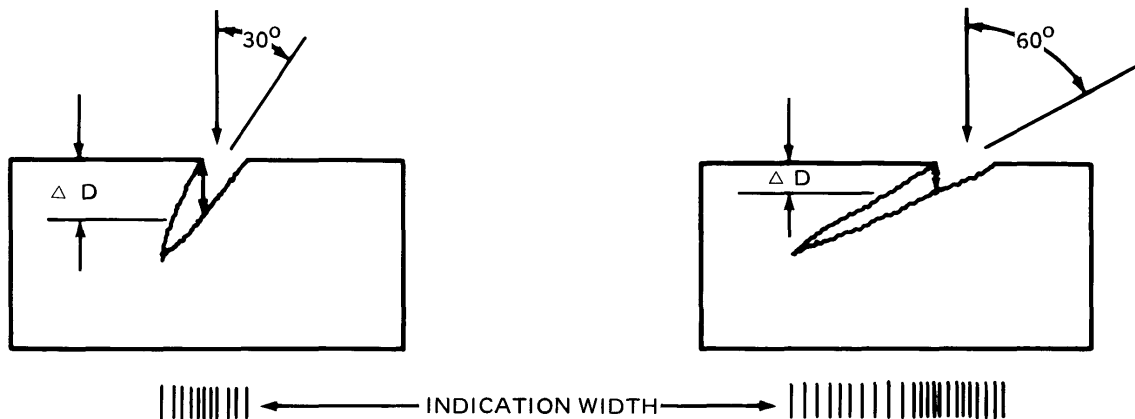
6.4.2.10.1 When an X-ray tube focal spot is centered directly over a crack with a depth parallel to the beam (X-ray beam and crack plane coincide), the film density change will be a function of the ratio of crack depth to metal thickness. Indications of narrow cracks with parallel sides will appear as fine dark lines with high contrast. Wide cracks with sloping sides will result in broader indications of lower contrast. A sketch illustrating the film density changes between two different width cracks when the X-ray tube is centered over the crack origin is shown in Figure 6-27. The stress on a part will affect crack width. Example: compressive stress in the lower wing surface of an aircraft on the ground tends to reduce crack width. This compressive stress is due to the weight of the structure, engines, ordnance pylons, etc. Jacking the aircraft, to place the lower surface in neutral stress or in tension is frequently done to enhance detection of small cracks. One general characteristic of a crack and its indication, is the tendency for it to curve or deviate from a straight line. An apparent exception is a very short

crack or a crack between two adjacent fasteners, but even here, when the indication is examined under magnification, there will be some edge jaggedness or change in edge appearance.



a. NARROW VERSUS WIDE CRACK INDICATION

NOTE
 ΔD IS EFFECTIVE DEPTH OR MAX DENSITY CHANGE.



b. SIMILAR WIDTH AND DEPTH CRACKS AT TWO DIFFERENT X-RAY BEAM TO CRACK PLANE ANGLES.

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Figure 6-27. Density Changes Due to Varying Crack Widths and Intersection Angles

6.4.2.10.2 Obtaining parallelism between the X-ray beam and the crack plane is difficult to achieve. Cracks do not always initiate at the expected origin, and often are not perpendicular to the part surface. When the X-ray beam passes through a crack at any angle other than directly along the crack plane, both the width of the crack and the intersect angle determine the density change and indication contrast. Two cracks, of approximately the same width and depth, but with differing angles to the X-ray beam and the crack plane intersection are shown in [Figure 6-27](#). As the angle between the X-ray beam and crack plane increases, both film density change and contrast decreases. The film indication becomes broad and more diffuse until it blends into the background and is no longer discernible.

6.4.2.10.3 Detection of cracks depends upon crack width, depth, total metal thickness, and angle of intersection. When only the intersection angle varies, it becomes a matter of statistics or probability. The probability of detecting a crack at vari-

ous intersect angles is reflected in [Table 6-11](#). This table indicates the probability of detecting a crack with an intersect angle of 9° is 75-percent. Conversely, the chances of missing a crack with a 9° intersect angle is 25-percent or 1 out of 4. When developing X-ray procedures to detect cracks, the maximum angle of intersection is 5°, which corresponds to an 85-percent probability of detection. The preferred limit is 2 1/2° corresponding to 90-percent detection probability.

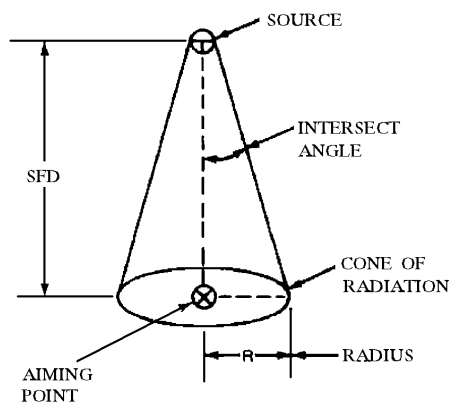
Table 6-11. Correlation Between Beam Divergence and Crack Detectability

Beam to Crack Angle (Degree)	Probability of Crack Detection (Percent)
0	96
3	89
6	82
9	75
15	48
21	30
27	23
45	4

6.4.2.10.4 An X-ray beam with a 2 1/2° or 5° intersect angle will not project over the surface of a 14-inch by 17-inch piece of film at normal focal-spot-to-film distances (FFDs). The entire film will be exposed, but only a small cone of radiation will be within the desired intersect angle limits. The radiation cone coverages at various intersect angles and FFDs is reflected in [Table 6-12](#). This table can be used to determine the necessary FFD when developing procedures. Example: A 12-inch long splice plate must be inspected for cracks. A 72-inch FFD is required ([Table 6-11](#)), to be within the 5° intersect angle limit, (6.3-inches on either side of the aiming point). Cracks occurring farther than 6.3-inches from the aiming point will produce indications with reduced film contrast and density change, meaning there is a greater chance of not detecting them. This emphasizes the need for information on probable crack location and orientation before developing an X-ray procedure. It also demonstrates the requirement for accurate tube head alignment during equipment setup.

Table 6-12. Radiation Cone Radii at Various Intersect Angles and SFDs

SFD	RADIUS of CONE (inches)				Intersect Angle
	2 1/2°	5°	7 1/2°	10°	
36"	1.57	3.15	4.74	6.35	
48"	2.10	4.2	6.32	8.46	
60"	2.62	5.25	7.9	10.58	
72"	3.14	6.3	9.48	12.7	
84"	3.67	7.35	11.06	14.8	



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6.4.2.11 **Scatter Radiation.** Whenever X-rays interact with material, one or more of the following will occur; absorption, scattering, or penetration. In industrial radiography, scatter radiation ([Paragraph 6.2.8](#)) can present a problem since it has the ability to expose the X-ray film without contributing to image information. Exposure of the film from scatter radiation is referred to as fog, and substantially reduces image contrast. Scatter radiation can have three different sources; reflected scatter, back scatter, and forward scatter ([Figure 6-28](#)). Reflected scatter comes from the area around any objects that might be in the radiation beam (e.g., the part under test, tube head stand or a wall). Back scatter is scatter radiation, which comes from objects behind the film (e.g., the floor). Forward scatter is the third source of scatter radiation, and is caused by the test object itself.

This scatter can obliterate an object's edges on the film, referred to as "undercutting." The amount of scatter radiation is affected by the radiation energy and the atomic number of the element causing the scatter. The lower the atomic number of a material, the greater the degree of scatter radiation. Materials with a high atomic number will cause less scatter.

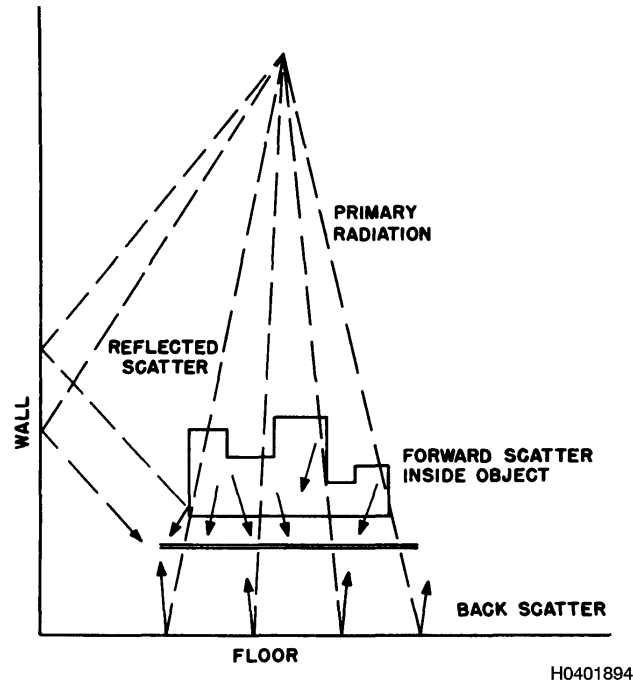


Figure 6-28. Sources of Scatter Radiation

6.4.2.11.1 Several techniques can be used to reduce scatter radiation. Radiographic cones or masks made of lead or other high absorbing materials will reduce the radiation area to only the area necessary for exposure. Lead in many different forms can be placed behind the X-ray film and test object to reduce excessive backscatter. Lead foil MAY be placed between the test object and the X-ray film to absorb some of the scatter radiation before the film is exposed. The lead foil acts as scatter filters since it permits the higher energy image forming radiation to be transmitted to the film, and at the same time absorbs the lower energy scattered radiation. A note of caution; filters in this position will reduce subject contrast. In some cases, the scatter problem can be of such a magnitude special techniques must be applied. Masking the part is often required because of large variations in part thickness, thus differences in absorption will lead to scatter from excessive amounts of radiation being transmitted through thin sections. Look at [Figure 6-29](#) to understand how a lead sheet could be used for masking. In this case, the object is a steel hub. Without the lead sheet (1/8 inch thick) definition would be poor due to internal scatter.

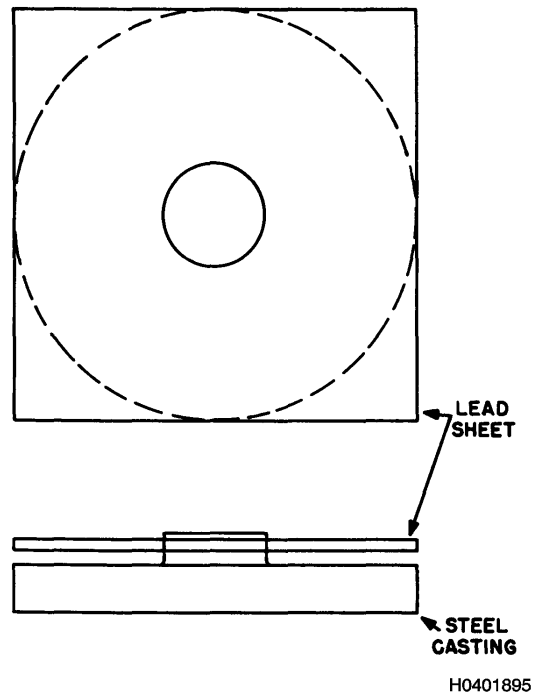


Figure 6-29. Masking to Avoid Scatter

6.4.2.11.2 Controlling scatter radiation requires common sense and ingenuity. A concrete, wood, or composition floor will generate enough back-scattered radiation to fog a film. Film holders SHOULD always be laid on, or backed with a sheet of 1/8-inch lead. The backing SHOULD be as large as possible to match the primary radiation field. This thickness of lead is enough for radiation generated up to 300 kV, except when fluorescent screens are in use, in which case a 1/4-inch sheet SHOULD be used. The “Potter-Bucky Grid” is a device constructed to specifically absorb object-scatter-radiation. This grid is made somewhat like a Venetian blind; it consists of strips of material, comparatively transparent to radiation, and strips of lead. The strips of lead absorb object scatter radiation at angles other than the direct beam. To prevent the lead strips from being revealed in the image, the grid is moved during exposure so the image of the lead strips is actually distributed over the entire image, but will not show detail. These grids are usually used in industry for radiography of low atomic materials where scatter is a problem of considerable proportions, especially in the medical field.

6.4.2.12 Effects of Processing. Processing variables, especially development time, also affect density and film contrast through their effect upon the slope of the characteristic curve. Tests with a typical industrial film showed as development time was reduced, the effect was to produce a family of characteristic curves displaced to the right. This means, the log relative exposure needed to produce a standard density, increased as development time decreased. There were other effects too. Optimum development time maximized the slope of the characteristic curve (and thus film contrast) at only slight cost in fogging [Figure 6-30](#)).

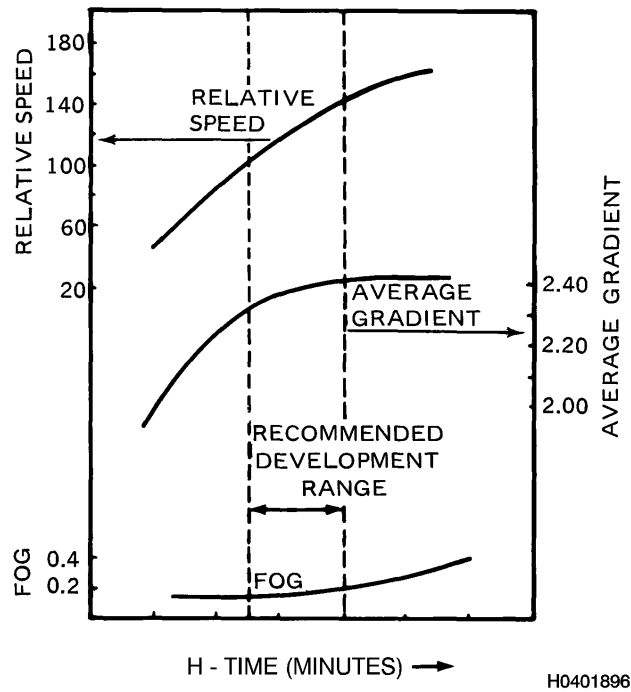


Figure 6-30. Effect of Development Time Upon Film Speed, Contrast, and Fogging

6.4.3 Radiographic Sensitivity. The following affects radiographic sensitivity:

6.4.3.1 Exposure Factor. The exposure factor is a quantity that combines milliamperage (X-ray) or source strength (gamma rays) with time and distance. Radiographic techniques are sometimes given in terms of kilovoltage and exposure factor, or radioactive isotope and exposure factor. In such cases, it is necessary to multiply the exposure factor by the square of the distance to be used to find, for example, the milliamperere-minutes or millicurie hours required.

6.4.3.2 Radiographic Contrast. Contrast in a radiograph is the difference in the resultant density, produced for a given change of X-ray or gamma ray absorption. It is affected by many factors, some of which must be compromised, thus, operator judgment becomes important. The choice of X-ray equipment is one of the most important considerations. The shorter the effective wavelength of X-rays, the greater the penetrating power. Also consider the higher the kilovoltage used, the shorter the effective wavelength of the generated radiation. As a result, the higher the X-ray tube voltage, the greater the penetrating power of X-rays generated. This is true for steel, with X-rays generated below 8 to 10 MeV, for aluminum, up to 20 to 22 MeV, and for lead, up to only 2 to 3 MeV (Table 6-13).

Table 6-13. Relative Absorption of Materials Material Kilovoltage Exposure

Material	Kilovoltage	Exposure Time	Thickness
Lead	200 kV	1 min	1/16 inch
Copper	200 kV	1 min	1/2 inch
Steel	200 kV	1 min	3/4 inch
Titanium	200 kV	1 min	1 inch
Aluminum	200 kV	1 min	4 inches
Magnesium	200 kV	1 min	5 inches

6.4.3.2.1 If the penetrating power of the radiation is great, each increment of thickness in the object will absorb less of the total than it would if the penetrating power of the radiation is lower. Conversely, if low kilovoltage is utilized, less of the total radiation will be transmitted through the object. Each small change in absorption due to thickness of material will

then cause a relatively large change in transmission, thus, the lower the voltage used, the greater the radiographic contrast. Therefore, kilovoltage MAY be lowered to perform an inspection, but SHALL NOT be increased above the level prescribed in the specific inspection instructions without approval from the responsible engineering authority.

6.4.3.3 Subject Contrast. Subject or object contrast SHALL also be considered by the radiographer. At X-ray voltages from 30 kV to 5 MeV, aluminum has a lower absorption rate per unit thickness than steel. Therefore, it takes a greater thickness change of aluminum to cause the same given change you would notice with steel. Hence, aluminum has less object contrast than steel. The change in thickness versus the change in transmitted radiation is graphically shown in [Figure 6-31](#). During the radiographic process, the differences in object contrast are, however, partially compensated for because lower energy radiation (longer wavelength) can be used to examine a given thickness of aluminum compared to the same thickness of steel (e.g., a 1-percent thickness change will produce sufficient density change on film to be visible when viewed on most metal subjects, but with magnesium and lighter metals, it is difficult to record 2-percent thickness change). Object contrast is a somewhat limiting factor in light metals and material with both low density and atomic number. The relations between X-ray absorption of steel, aluminum, and magnesium are shown in [Figure 6-32](#).

NOTE

It is recommended on light materials, the radiographer SHOULD use lower kilovoltage, and consequently, longer exposure time than on heavier materials.

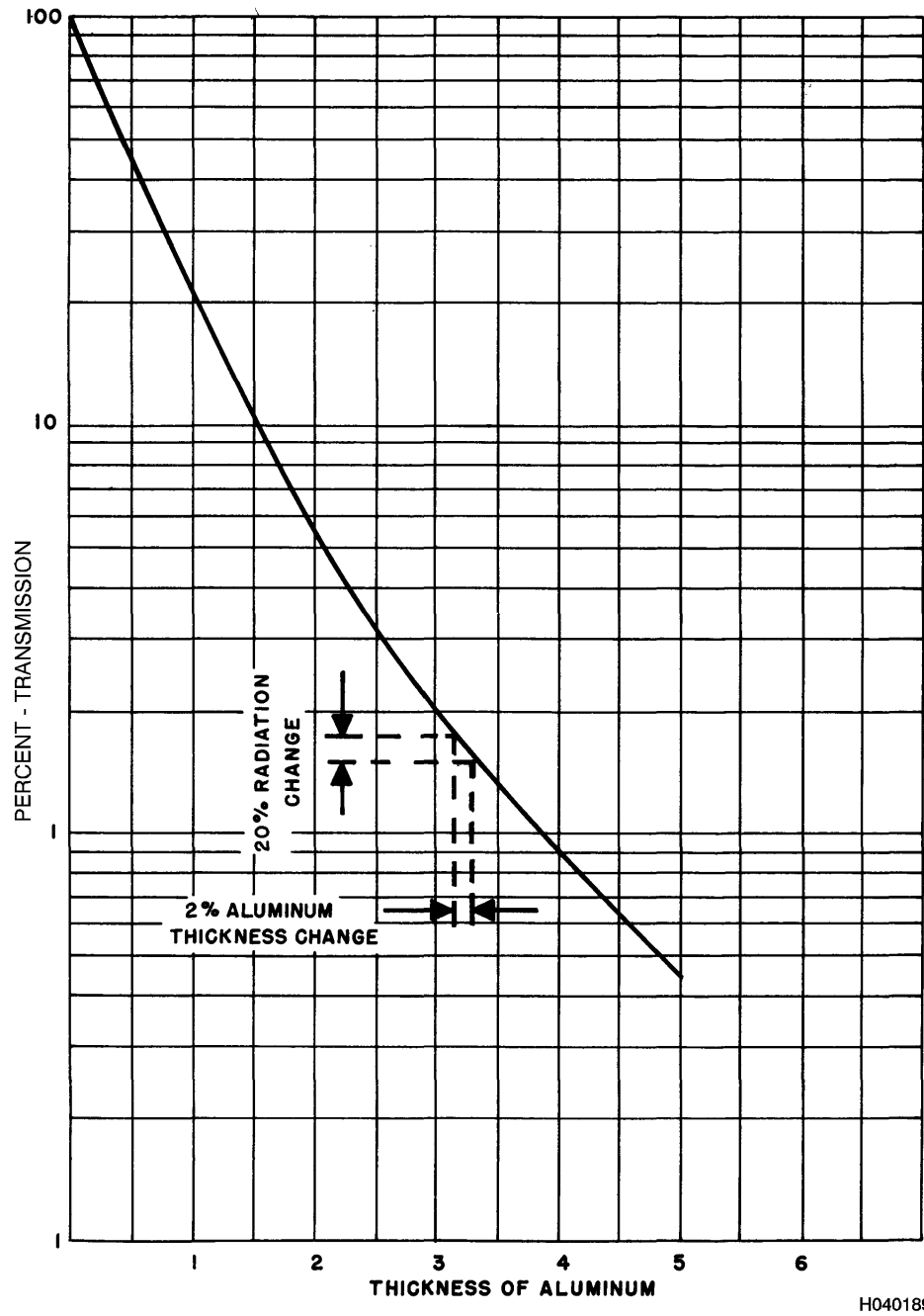
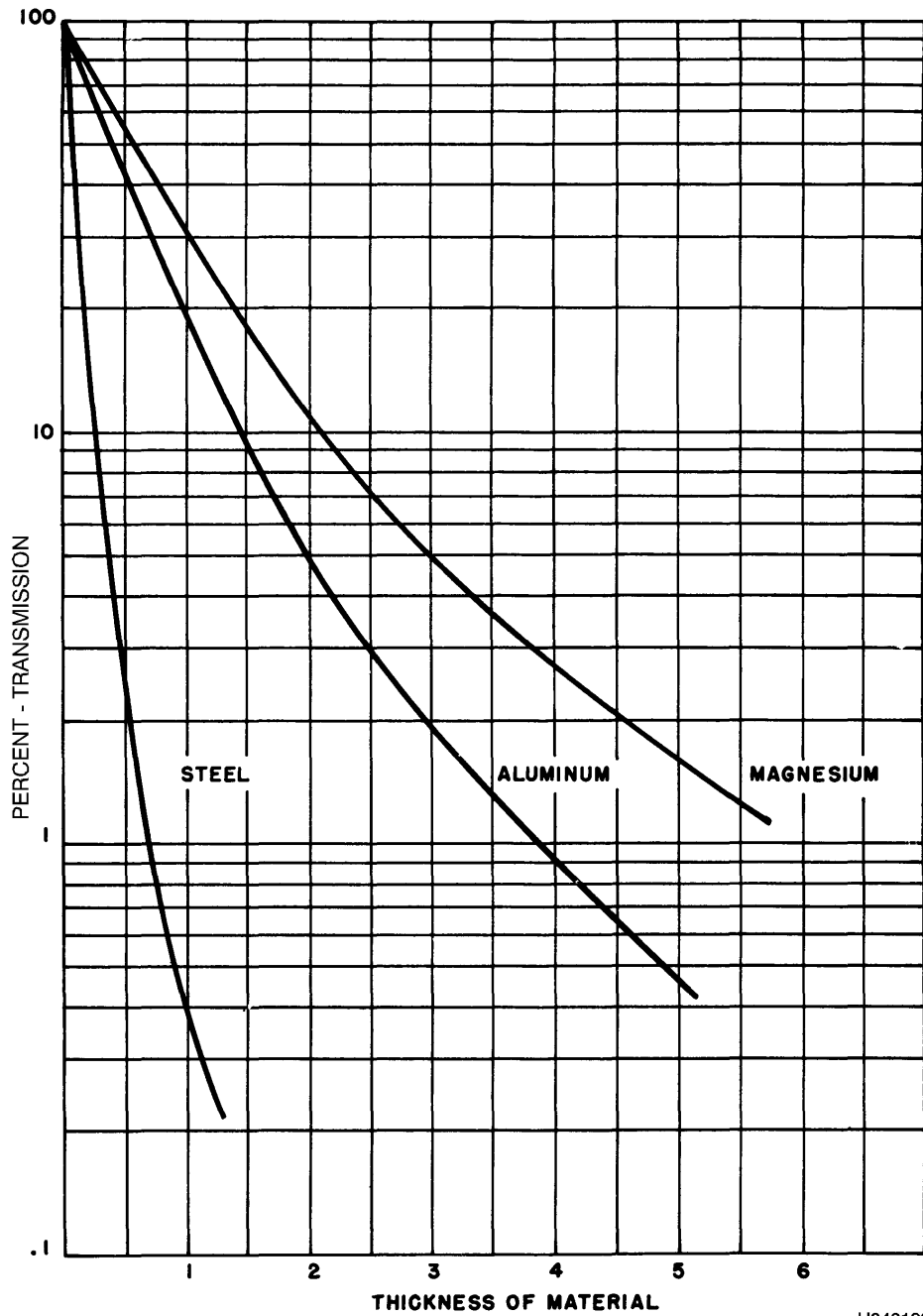


Figure 6-31. Radiation Transmission Versus Thickness of Aluminum at 150 kV



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Figure 6-32. Radiation Transmission Versus Thickness for Various Densities at 150 kV

6.4.3.3.1 For materials of approximate uniform thickness, where the range of transmitted X-ray intensities is small, the technique producing high contrast will show all portions of the area of interest with an increased radiographic sensitivity; however, if the part radiographed transmits a wide range of X-ray intensities, a technique producing lower contrast will be necessary to record the detail in all portions of the radiograph, probably with some decrease in radiographic sensitivity. In cases where an extreme range of intensities is transmitted, high radiographic contrast MAY be obtained by double-loading the film holder with two high-contrast films of different speeds. The kilovoltage and exposure are so chosen that the thick portions of the object be satisfactorily recorded on the faster film and the thin portions on the slower film.

6.4.3.4 Film Contrast. Film of the no-screen type generally give higher contrast with or without lead screens than screen type films with or without lead screens. Screen type films with calcium tungstate screens, however, produce maximum contrast with sacrifice of detail due to the grain size of the screens. The contrast of a film can be seen from the slope of the characteristic curves.

6.4.3.5 Film Latitude. The film characteristic reverse of contrast is film latitude; the higher the film contrast, the smaller the film latitude; and the lower the film contrast, the greater the film latitude. Film latitude is the range of radiation intensities a film is capable of recording.

6.4.4 Improving Radiographic Sensitivity.

6.4.4.1 Using Quality Indicators. Earlier, we discussed the equipment ([Paragraph 6.3.8](#)). Now we will discuss their use.

6.4.4.1.1 Contrast Sensitivity. The IQI material thickness is added to the thickness of the test object. This increase in thickness causes more radiation to be absorbed, and the IQI outline is seen on the final image as a less dense area. This change in film density due to the additional radiation absorption is a measure of the image contrast. The human eye is normally used as a detector in reading radiographic images, and the eye responds to differences in the quantity of light being transmitted through the film due to the density differences. It is assumed under practical industrial film inspection conditions, the human eye is capable of just detecting density differences of 0.02, which corresponds to a light transmission difference of 4.72-percent. Since density differences of 0.02 are considered just barely discernible, good practice is to strive for a density difference of 0.08 to assure good visualization of discontinuities.

CAUTION

IQIs SHALL always be removed from the specimen after inspection on aircraft.

6.4.4.1.2 Detail Sensitivity. Detail sensitivity of the radiographic image is revealed by the capability of visualizing the IQI holes or applicable wire number. When the 2-percent IQI is used on the test object, it is usually required the 2T IQI hole is visible on the radiograph. If the 2T hole can be seen, the image is said to have 2-percent radiographic sensitivity. The film reader can then assume the capability of seeing any discontinuity that represents a 2-percent dimensional change of the object total thickness. The 1T hole, DOES NOT represent 1-percent image sensitivity because the thickness of the IQI has not been reduced to 1-percent of the test object thickness. Calculations reveal visualization of the 1T hole in a 2-percent IQI actually reveals 1.4-percent image sensitivity. Resolution of the holes in the IQI is a combined measure of image sharpness and contrast, and is thus a measure of the image quality, but note the regular and expected outline of the holes is more readily seen than a crack line. The IQI SHALL NOT be placed over an area of interest, since the IQI or the lead identification numbers could hide discontinuities. In some cases, the IQI cannot be placed on the actual test specimen. In these instances, it is acceptable to place the IQI on a separate block of the same material and of the same thickness as the specimen. Remember, when placing an IQI, the purpose of the IQI is to reveal image quality to the film reader, therefore, place it in the least disruptive position. Also remember, when placing the IQI, the density SHOULD NOT vary more than +30 or -15-percent from the area of interest. Plaque IQI suffer from a number of disadvantages, the most serious of which is the minimum thickness of 0.005 inches. ASTM E1742 provides additional information on the use of IQIs. The preceding actions have shown effective radiographic inspection requires techniques that have optimum geometry, film choice, contrast, and density. Subsequent paragraphs explain how characteristic curves and technique charts can provide quantitative data to permit precise adjustments.

6.4.4.2 Screens. The radiation reaching the film may be, in part, caused by the use of intensifying screens to reduce the exposure time. The intensification factor for lead or calcium tungstate screens depends on the energy converted to either electrons or light to which the screen is sensitive. This factor varies with kilovoltage and type of film. The film SHALL be selected to achieve the highest efficiency of energy conversion from the screens used. The use of screens is covered more thoroughly in [Paragraph 6.3.7.9](#).

6.4.4.3 Technique Charts. The characteristics of X-ray equipment SHALL be known to properly operate the unit and obtain maximum results. The utilization of X-ray equipment with the least amount of lost time requires a set of technique charts, which show the exposure times required for various thicknesses of material under stated conditions. These charts are generally available from the manufacturers of X-ray machines ([Figure 6-33](#)). Due to the differences between individual equipment, it MAY be necessary or desirable to prepare additional technique charts for the specific purposes and conditions for which the equipment will be applied. If published technique charts are available, they can be used as a guide in preparing the detailed charts.

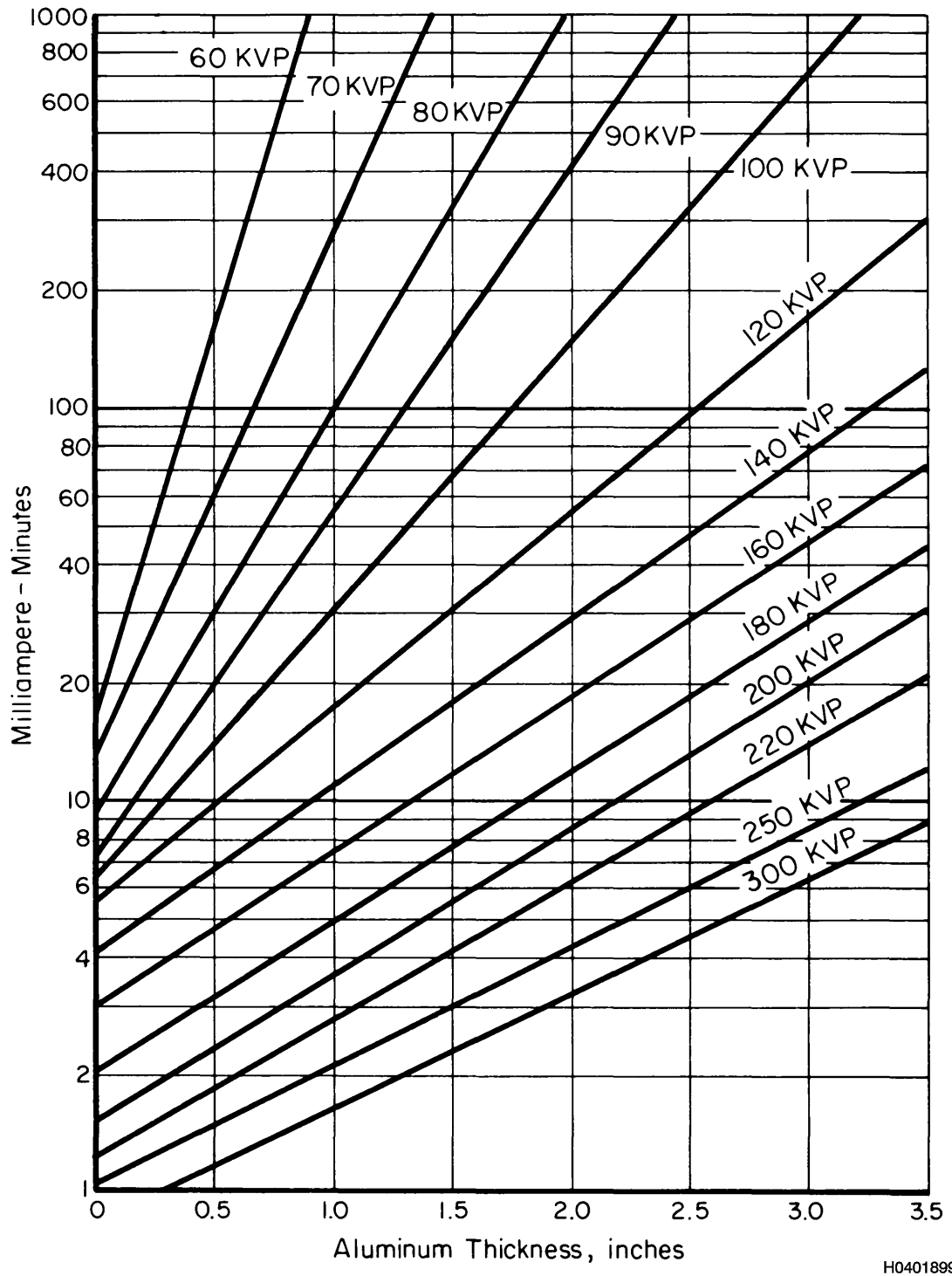


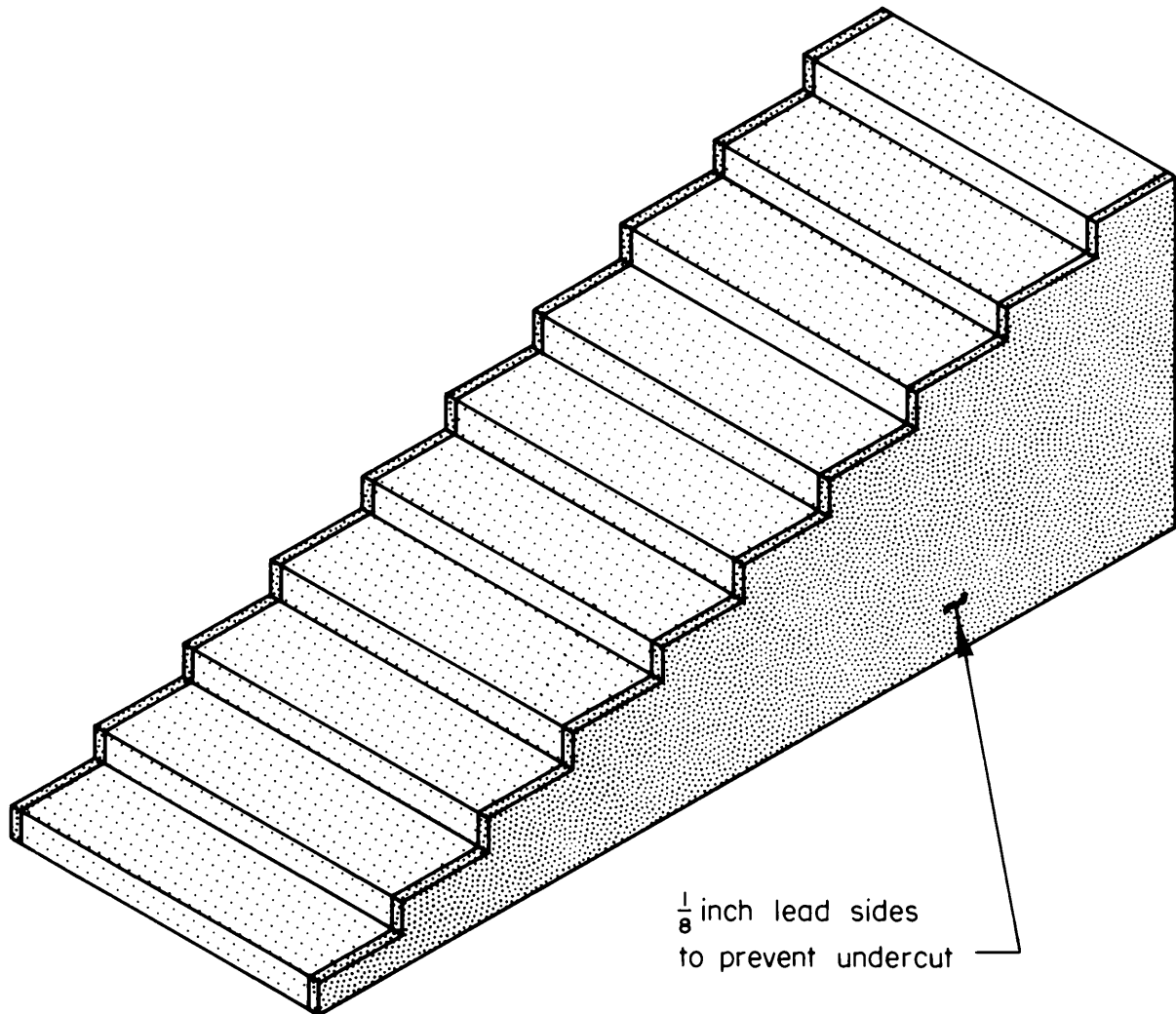
Figure 6-33. A Typical X-ray Exposure Technique Chart

6.4.4.3.1 Identification of Technique Charts. The following items must be recorded to adequately identify technique charts:

- Type of unit.
- Material (type and thickness).
- Film type.
- Quality Enhancers (screens).
- Kilovoltage.
- Current and exposure time.
- Source-to-film distance.
- Film processing factors (temperature, method, etc.).
- Density of radiograph desired.

6.4.4.4 Step Wedge Radiographs. A step wedge MAY either be a solid block, or made up from plates of the same material used as the object being radiographed ([Figure 6-34](#)). A radiograph of the step wedge will give a symmetrical shadow picture of varying densities corresponding to the steps on the wedge. Make a series of radiographs of the step wedge at different exposures while keeping other radiographic factors constant (including subsequent processing). Preparation of the technique chart requires the following steps:

- a. Select an estimated exposure for the thinnest section of the step wedge, based on exposures for similar material in the middle of the voltage range, or a trial exposure on this material. In planning the exposures, pick out a series in an approximate geometrical progression. For example, a series of 120 MAS, 220 MAS, 320 MAS and so on might be chosen.
- b. Expose the step wedge under the conditions previously selected, at the times calculated for the mid-voltage point.
- c. Process the radiographs using fresh solutions, mixed according to manufacturer's directions.



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Figure 6-34. Sketch of Desirable Stepped Block for Radiation Measurements

6.4.4.5 Plotting the Data.

NOTE

The “Constant Exposure Chart” is used to plot data for a single kilovoltage setting. Additional curves for other kilovoltages can be made by repeating the procedure at any desired kilovoltage.

6.4.4.5.1 Constant Exposure Chart. Make density measurements of each step on each of the radiographs with a densitometer and record this data in a table. The final table SHOULD show a density for each step thickness at each exposure. Now plot this data on semi-logarithmic graph paper with density and object thickness as the coordinates. This will give a set of curves, one for each exposure. This is a Constant-exposure chart and is only one type of technique chart.

6.4.4.5.2 Constant Density Chart. It is more common to plot technique charts in the form shown in [Figure 6-35](#). This is a constant-density chart for three different kilovoltages. To prepare this type of technique chart, it is necessary only to plot points taken from the graph prepared in [Paragraph 6.4.4.3](#). Record and plot the points for each thickness at the intersection of the selected density and exposure curves. This will result in a single curve on the constant density chart for one kilovoltage.

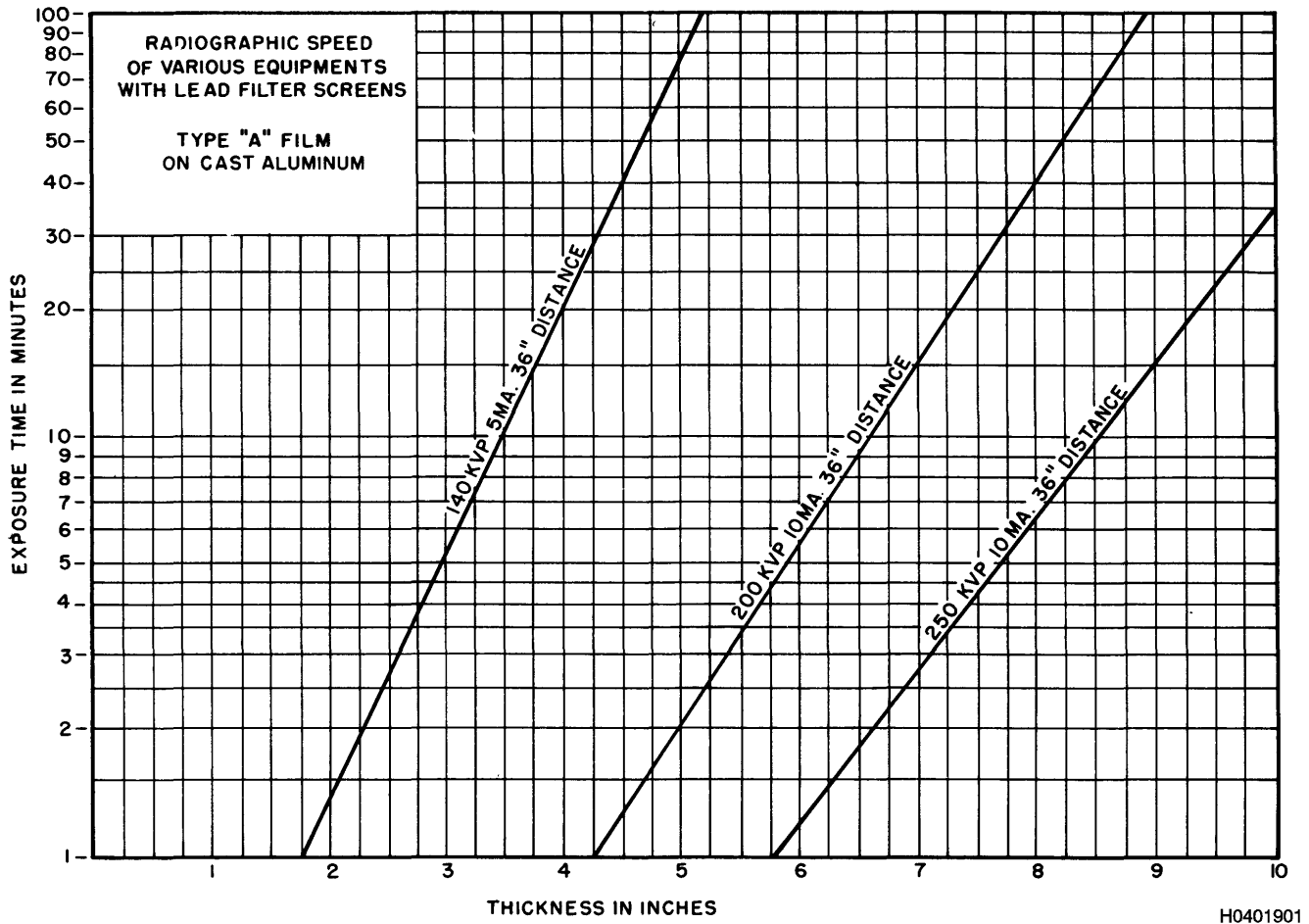


Figure 6-35. Typical Technique Constant-Density Chart

6.4.4.5.2.1 Constant-density charts MAY also be prepared directly from the radiographs if a set of constant exposure charts is not desired. To do this, proceed as follows:

- a. Select the exposure and thickness of the step wedge that will produce the desired density.
- b. Plot this exposure of time versus the thickness of material on a sheet of semi-logarithmic graph paper, and label this line with the kV used for this series of exposures.
- c. Repeat the above procedure for a series of voltages through the voltage range of the equipment.

6.4.4.6 Logarithms (log). The use of logarithms is discussed further ([Paragraph 6.7.6](#)).

6.4.4.6.1 Since logarithms are used a great deal in the interpretation of radiographs, a brief discussion of them is included here. A more detailed treatment will be found in [Paragraph 6.7.6](#) and some handbooks and intermediate algebra texts. Before discussing logarithms, it will be necessary to define the term "power." The "power of a number" is the product obtained when it is multiplied by itself a given number of times, thus $10^3 = 10 \times 10 \times 10 = 1,000$ and $5^2 = 5 \times 5 = 25$. In the first example, 1,000 is the third power of 10; in the second, 25 is the second power of 5, or 5 raised to the second power. The figure ² is known as the exponent. Fractional exponents are used to denote roots.

6.4.4.6.2 Negative exponents indicate reciprocals of powers, thus the base 10 logarithm of a number is the exponent, or the power to which ten must be raised to give the number in question. For example, the log of 100 is 2. The log of 316 = 2.50;

the log of 1,000 is 3. It is also said that 1,000 is the antilogarithm (antilog) of 3. Logarithms consist of two parts: a decimal, which is always positive, called the mantissa; and an integer, which MAY be positive or negative, called the characteristic. In the case of $\log 316 = 2.50$, "0.50 is the mantissa" and "2 is the characteristic." No matter what the location of the decimal point might be, the logarithms of all numbers having the same figures in the same order have the same mantissa.

6.4.5 Darkroom Design. A dark room is required to process exposed film. Dark rooms provide a space to open exposed radiographs under safe conditions. Darkroom space SHOULD be determined by work volume, but in general, a high efficiency operation can be achieved when the space allows two to three persons to work together at the same time. The darkroom SHALL be completely protected against radiation and visible light. The walls of the darkroom SHALL be painted a light color which best reflects light from the safelight. A ventilator SHOULD be used to keep the air moving from the dry side to the wet side of the room and out. The darkroom SHOULD have an antechamber type entrance that makes an efficient light trap.

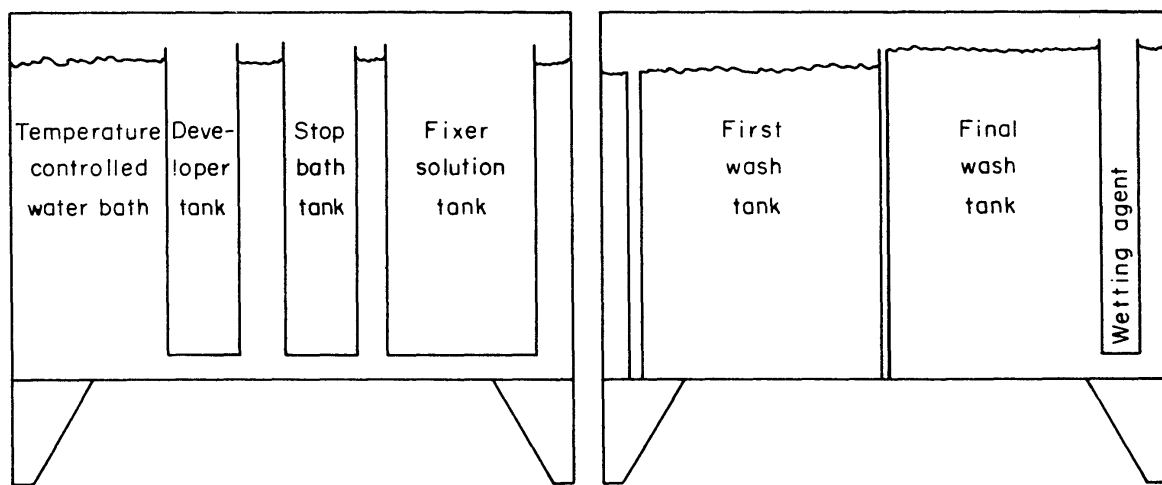
6.4.5.1 Preferably there SHOULD be a film loading darkroom and a processing darkroom. If film loading, unloading, and processing are to be carried out in the same darkroom, the wet area SHALL be in a position opposite the dry area. The following precautions SHALL be observed when the darkroom area is large enough for a loading darkroom and a processing darkroom.

6.4.5.1.1 Darkroom Loading (Dry Area). The loading darkroom is to be provided with film containers, cassette and film holder storage, and a loading bench. The loading darkroom SHALL always be kept clean, and free of water and chemicals.

6.4.5.1.2 Darkroom Processing (Wet Area). The processing tanks, washing tanks, hangar racks, and work benches SHALL be arranged to facilitate film processing. Since the air is readily contaminated in a hot and humid processing darkroom, forced ventilation SHALL be used. An air conditioner MAY also be necessary to keep the air dry.

6.4.5.1.2.1 A dark room, which is used for other types of film processing, MAY be used for processing radiographs unless the various activities interfere with each other.

6.4.5.1.3 Arrangement for Manual Processing. Suggested arrangement of manual processing tanks is shown in [Figure 6-36](#). The chemicals SHOULD be arranged as shown in the sketch in sequential steps of the process and traversing from left to right. This arrangement is used with the assumption most people are right-handed.



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Figure 6-36. Suggested Arrangement of Manual Film Processing Tank

6.4.5.1.3.1 Assuming a developing time of 5-minutes, a single 5-gallon tank will develop 30 films an hour. The stop bath tank SHOULD have a capacity equal to the developing tank. The capacity of the fixing bath tank SHOULD be double the developing tank. The wash tank SHOULD hold from 20 to 25 gallons. Install the wash tank so films are placed in the tank at

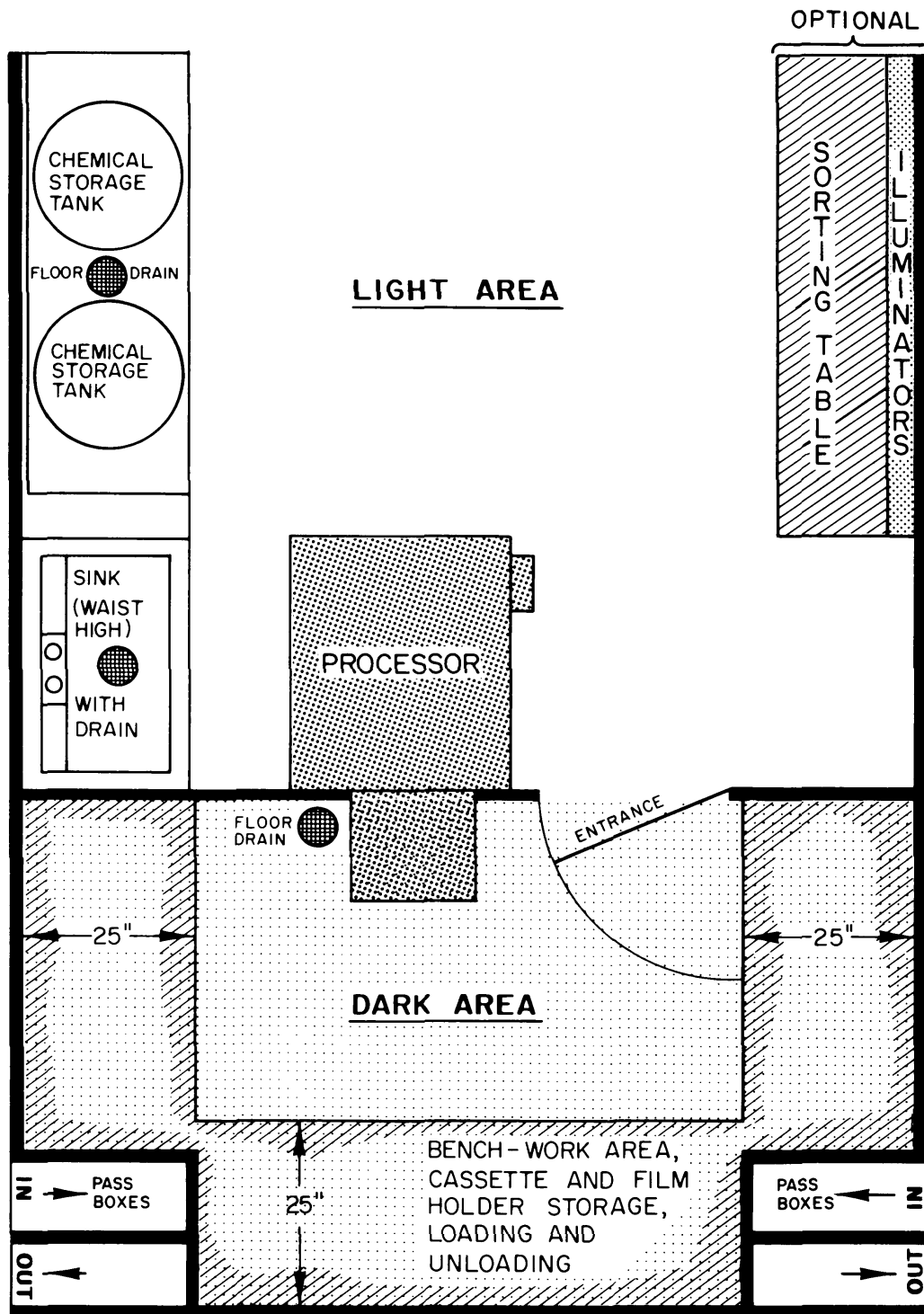
the outlet end. If dark room volume requirements must be greater, use the above relationships to plan the additional facilities. The finish of the benches, walls, and floor adjacent to the tanks SHOULD be adequate to protect against the action of chemical solutions and water that might be spilled on them.

6.4.5.1.3.2 Film bins are desirable since they are light-tight and close automatically. The boxes of film can be stored here in perfect safety and are readily available. For the mixing of chemicals, enamel pails, several funnels and stirring rods must be provided. Where films must be dried rapidly, film drying cabinets are necessary. These dryers SHOULD have a filtered air intake, film racks, exhaust fan, and heating element. It is best to wire the fan and heating elements on the same circuit so the heating element cannot be turned on without the fan.

CAUTION

There might be a time when film jams within the processor. In this situation, the processor lid MAY need to be removed, exposing any undeveloped film to light. Care SHALL be taken to prevent exposure to undeveloped film by working under safelight.

6.4.5.1.4 Arrangement for Automatic Processing . The general arrangement of a darkroom, where an automatic processor is used, is illustrated in [Figure 6-37](#). The loading end of the processor is located in the dry area of the darkroom and is under safelight illumination. The output end of the processor is generally located on the outside of the darkroom wall under ambient illumination. When processing film in the automatic processor, the film is unloaded from the cassette film holder as in manual processing. However, it is then immediately fed into the loading end of the processor. After processing is completed, the film exits the other end of the processor. At this point, the film is ready for interpretation and filing as required. Cleanliness in automatic processing is essential. Lint and other contaminants, if they are allowed to enter the processor, can cause many spots as they collect on rollers and affect subsequent films.



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Figure 6-37. Typical Arrangement of Through-the-Wall Automatic Processing Darkroom

6.4.5.2 Safelight.

CAUTION

Keep exposed film a minimum of 1-meter away from the direct light of the safelight; exposed films are more sensitive to illumination from safelights than are unexposed films. Screen-type films are more sensitive to fogging than non-screen film. In addition, emulsions are less sensitive when wet, so they can be exposed to safelights for longer periods after immersion in the developing solution.

Light having spectral qualities outside the region in which sensitive materials are affected is to be used for safelight illumination. A safelight filter, colored dark reddish orange or equivalent is recommended for use in the darkroom. Industrial X-ray films SHALL be handled at a distance of at least 4 feet from a safelight. The safelight MAY be turned on under normal conditions for 10 to 15-minutes without any detrimental effect on X-ray film. Safelights require process control which is located in [Paragraph 6.6.3.3](#).

6.4.5.3 Processing Tanks. Processing solutions are either alkaline or acidic, therefore, the processing tanks must be alkali or acid resistant. Suitable materials include: stainless steel, plastics, and enamelware.

6.4.5.3.1 Plastics have such low thermal conductivity, that plastic containers are suitable for keeping processing solutions warm, but the contents of such containers cannot be rapidly heated or cooled from the outside. Stainless steel which provides adequate protection against corrosion and provides easy temperature control is widely used.

6.4.5.4 Dark Room Cleanliness.

NOTE

If spilled chemicals settle on film and evaporate, they may cause spotting.

Due to the sensitivity of X-ray film, cleanliness is very important. Work areas and any accessories (e.g., film hangers, funnels, stirring rods, and thermometer) SHALL be washed thoroughly after use to avoid contaminating film. Processing tanks SHALL be scrubbed clean before filling with fresh solution. It is advisable to sterilize the tanks periodically with a 5-percent solution of sodium hypochlorite (bleach). Allow the sterilizing solution to remain in the tank overnight and then drain and rinse thoroughly. If any solution is spilled, wipe it up immediately.

6.4.6 Radiographic Film.

6.4.6.1 Film Comparisons. Manufacturer's literature generally provides speed, contrast, and processing data pertinent only to the films and chemicals they produce. Presentation of the data differs greatly from one manufacturer to another, as do their methods for developing this data. Historically, when faced with the necessity to substitute one manufacturer's film with another manufacturer's film, the radiographer would compare manufacturer's literature and then perform trial exposures with the new film. Using the first radiograph as a basis, the radiographer would modify the exposure parameters and try again. Often this procedure would have to be repeated several times, depending on the experience of the radiographer and difficulty of subject, before an acceptable radiograph was produced. We even find the process used by manufacturers to make the film varies to such an extent that the different film emulsions will have different effects on different processing techniques and chemicals. This iterative process involves considerable expenditure of time and significant cost in supplies. When evaluating a new film, the radiographer SHOULD contact the responsible engineering authority for that weapon system and request current information on how each manufacturer's film works for that specific application.

6.4.6.2 Care of Radiographs. The final radiograph represents a considerable investment of time and money; great care SHOULD be taken to preserve the final image. Unexposed X-ray films are highly sensitive to, and adversely affected by, chemicals, heat, moisture, mechanical pressure, visible light, and radiation such as X- and gamma rays. Utmost care therefore SHOULD be taken in the handling of such films and in the selection of storage locations.

6.4.6.3 Handling of Radiographs. The radiographs SHOULD NOT be handled with bare hands, and always handle the film at the extreme edges. The emulsion layer is scratched when strongly rubbed, so black streaks appear in the processed radiograph. A low density shadow, looking like a crescent mark or "flare," is seen in the radiograph when the film is folded or

flexed. Generally, the crease made in a film before exposure has a lower density than one made after exposure. Mechanical pressure also influences the film likewise. The film SHOULD NOT be crimped or sharply bent. Soft, white, cotton gloves SHOULD be used to handle all radiographs between the time they are processed and the time they are disposed of. Thin, soft, cotton gloves SHOULD be worn to avoid marks resulting from contact with fingers contaminated with body oil, lotion, or processing chemicals. The use of gloves made of synthetic fibers or gloves of synthetic fibers blended with cotton SHOULD be avoided, since they could cause static marks. Foreign substances such as water, coffee, or other materials SHOULD NOT be allowed to contact the emulsion surfaces. The films SHOULD always be picked up carefully, never sliding them across surfaces that could be dirty or have some gritty substances that can introduce scratches on the emulsion surfaces. If the film is interleaved the interleaving paper SHOULD be left on the film when it is placed on the work bench before exposure, as it protects the film from dirt, iron powder, moisture, chemicals, and other undesirable matter. When attempting to interpret high-density film areas with high-intensity illuminators, care SHOULD be used to prevent overheating of the radiograph. White cotton gloves can be ordered through the supply system.

6.4.6.3.1 Good uniform contact between the screens and the film is very important. If they are in poor contact, the image sharpness will be adversely affected. Particular care SHOULD be used to obtain good contact between the screens and the film when the cassettes are of the flexible type. When removing the film from a film holder, remove the film by opening the screens, therefore avoiding friction between screens and film.

6.4.7 Film Handling Problems.

6.4.7.1 Problems Associated with Storage.

6.4.7.1.1 Fogging from Light.

Phenomenon:

The radiograph is fogged in the same pattern as the interleaving paper texture.

Problem Cause:

The film has been exposed to light while yet covered with interleaving paper.

Corrective Action:

1. Check the darkroom for light leaks.
2. Check the X-ray film storage box for light leaks.
3. Before turning on the normal room lights, make it a rule to ensure no film is on the work bench.
4. Be sure to seal the X-ray film case after use.

6.4.7.1.2 Fogging from Radiation.

Phenomenon:

The shadow of an unexpected object or the head foil as embedded in the X-ray film case appears in the radiograph.

Problem Cause:

The film has been exposed to X- or gamma rays during storage.

Corrective Action:

Keep X-ray films in a lead foil coated X-ray film storage box and store in a radiation free environment.

6.4.7.2 Problems Associated with the Safelight.

6.4.7.2.1 Fogging from Safelight.

Phenomenon:

The radiograph has a fog on one side or shows letter form shadows.

Problem Cause:

1. White light is leaking from a slit in the safelight box.
2. The film has been allowed to stand under safelight illumination for too long a time or placed too near the safelight.
3. A lamp having a higher capacity than standard rating is used as the safelight source.

Corrective Action:

1. Check the safelight filter periodically (every six months to once a year) and replace it if faded.
2. Observe safelight requirements, such as the prescribed lamp wattage and safelight-to-film distance, and complete work under safelight illumination as quickly as possible.
3. Periodically check to ensure the safelight is functioning under normal prescribed conditions.

6.4.7.3 Problems Associated with Handling Before Development.

6.4.7.3.1 Dirt Deposits or Stains on the Screen.

Phenomenon:

The radiograph has irregular shaped light spots.

Problem Cause:

There are dirt deposits or stains on the intensifying screens.

Corrective Action:

1. Keep the surfaces of intensifying screens clean and dry at all times.
2. Wipe the surfaces of intensifying screens with cleaner from time-to-time.

6.4.7.3.2 Spots on the Radiograph.

Phenomenon 1:

The radiograph has dark spots of a relatively low density.

Problem Cause:

Water was splattered on the film.

Phenomenon 2:

The radiograph has dark spots of high density

Problem Cause:

Developer solution was splattered on the film.

Phenomenon 3:

The radiograph has light and dark spots of a relatively low density.

Problem Cause:

Stop bath solution was splattered on the film.

Phenomenon 4:

The radiograph has light spots which are barely developed.

Problem Cause:

Fixer solution was splattered on the film.

Corrective Action:

Handle the films at such a distance from the processing area that water and processing solutions cannot affect them.

6.4.7.4 Problems Associated with Loading and Unloading.

6.4.7.4.1 Film Adhesion.

Phenomenon:

The radiograph has irregular shaped spot-like marks.

Problem Cause:

The film loaded in the cassette adhered to the intensifying screen.

Corrective Action:

1. Do not leave film in a cassette for a long period of time during hot, wet seasons or in a hot place.
2. When the cassette is wet, leave it to dry in the shade choosing a place where there is a good draft.

6.4.7.4.2 Static Marks.

Phenomenon:

The radiograph has tree-like or branching marks.

Problem Cause:

Static marks result from the contact, peeling, or friction of foreign matter caused by static electricity. They are apt to occur when the air is dry.

Corrective Action:

1. Keep the darkroom air at the proper humidity levels (60 to 70-percent RH).
2. Any materials of rubber or synthetic fibers, which are easily charged with static electricity, SHOULD not be used near the film.
3. Handle the film gently.
4. Ground the darkroom workbench.

6.4.7.4.3 Kink Marks.

Phenomenon:

The radiograph has light or dark marks which are crescent shaped or irregular.

Problem Cause:

The film was broken locally or sharply bent during handling. Dark marks appear when the film is sharply bent before exposure while sharp bending of an exposed area may become the cause of light marks.

Corrective Action:

1. Carefully hold the edge of the film and avoid bending it.

6.4.7.5 Problems Associated with Post-Development Processing.

6.4.7.5.1 Uneven Fixing.

Phenomenon:

The radiograph has light, irregular shaped marks, or streaks.

Problem Cause:

Fixing proceeded locally.

Corrective Action:

1. Agitate the film in the fixer solution at frequent intervals, especially in the early course of fixing.
2. Replace the fixer solution with a fresh one before it is exhausted beyond use.

6.4.7.5.2 Uneven Drying.

Phenomenon:

The radiograph has light, blurred lines, or irregular shaped marks of film surface luster.

Problem Cause:

Draining was incomplete and uneven so the drying speed differed from one area to the other.

Corrective Action:

1. Use a wetting agent to drain the film evenly.
2. When hot air is used, gradually heat the air that is blown over the film.

6.4.8 Preparation for Manual Processing.

- a. To place the film on the film hanger, grasp one upper corner between the thumb and index finger and fasten it to the hanger with one of the bottom hanger clips.
- b. Fasten the other bottom clip and finally the two top clips.
- c. The film SHOULD be flat and taut with the punched number (if any) at the bottom of the hanger to prevent streaking due to developer flow through the holes when processing. If it is not, repeat the procedure.

6.4.9 Storage of Radiographs. Industrial film SHOULD NOT be stored near a radiation source. Precautions SHALL be taken to ensure unexposed radiographic film is protected from exposure to radiation by storing film in a lead lined container or in a room removed from X-ray operations. If an exposure is suspected, perform a fog test on a sample film processed with all safelights off. Background density shall not exceed 0.30 density units total. If the film fails the fog test it SHALL be used for training or clearing only.

6.4.9.1 Industrial X-ray films are quite sensitive to heat and moisture, therefore, a cool dry place SHOULD be chosen for storage. Storage temperatures SHOULD be maintained in the 40 to 75°F (5 to 23°C) range. Once film is removed from the envelope, the emulsion will absorb moisture until it attains equilibrium with the moisture content of the surrounding air. On the other hand, excessive dryness is not suitable to the storage of industrial X-ray films, because in such locations films might change with static electricity, resulting in plus-density marks on the radiographs. When X-ray film is not allowed to stabilize at room temperature moisture may condense on the film when it is removed from its protective envelope.

6.4.9.2 Industrial X-ray films could develop fog when exposed to polished metal surfaces, painted surfaces, hydrogen peroxide, coal gas, hydrogen sulfide, ammonia gas, mercury vapor, formalin, engine exhaust gases, acetylene, and terpene. Provisions SHALL be made to prevent this kind of fog, which is referred to as a false sensitometric effect.

6.4.9.3 The final radiographs SHOULD be placed in film filing envelopes for final storage. These envelopes are constructed of heavy paper to protect the films. The envelope SHOULD be identified as to the radiographs it contains and filed in a systematic manner to facilitate retrieval if and when necessary. Envelopes SHOULD be marked prior to insertion of the film to prevent pressure marks. Films SHOULD NOT be stored in high humidity areas. Film filing cabinets are available for film storage. Ordinary filing cabinets are not sufficiently strong to withstand the heavy loads of filed film. X-ray films present no greater fire hazard in storage than an equal quantity of paper records. There is no necessity for expensive vaults equipped with elaborate fire protection devices. The storage area must be kept clean.

6.4.9.4 The disposition for industrial radiographs is referenced in AFRIMS through the AF Portal. Specific inspection instructions and TO 00-20-1 SHALL be consulted to determine which inspection radiographs SHALL become part of official aircraft/support equipment records. All radiographs SHALL be disposed of according to the Precious Metals Recovery Program (PMRP) in AFI 23-101.

6.4.10 Processing Chemicals.

CAUTION

Manufacturers material data sheet SHALL always be followed when using their chemicals.

Liquid and powdered chemistry in concentrate form are available for manual and automatic processing. When mixed with appropriate quantities of water, these solutions are then ready for the processing sequence of industrial X-ray films.

6.4.10.1 Chemicals for Manual Processing.

6.4.10.1.1 Developer. When radiographic film is exposed to ionizing radiation, an invisible image (called a latent image) is formed in the emulsion layer of the film. The process of converting the latent image to a visible image is called development, and a developer solution is used in this process.

6.4.10.1.1.1 Developer Composition. Chemically, “development” refers to the reducing action of a chemical. It is necessary to reduce only the silver compound deposited in the latent image of exposed film during exposure to metallic silver to form a visible image. The chemical which is chosen to reduce the exposed silver compound to metallic silver is called a developing agent. The developing agent is not used alone, but in combination with other ingredients which perform special functions. They include the accelerator which activates the developing agent, the preservative which reduces the aerial oxidation of the developer, the restrainer which prevents development fog by restraining the action of the developer on the unexposed silver compound, and other additives used to harden the gelatin and soften the water among other things.

6.4.10.1.1.2 Many developers are kept alkaline by the accelerator. The more alkaline the developer or the greater the quantity of accelerator added to the developer, the stronger the action of the developer. The developer for X-ray film contains more ingredients than the developers for conventional black-and-white films because a larger quantity of silver halide is used in X-ray film.

6.4.10.1.2 Stop Bath. The silver image becomes too dense to serve the intended purpose unless the action of the developer is stopped at a proper time. If, in the case of manual processing, the film is directly transferred from the developer to the fixer, uneven fixation could occur. To stop the action of the developer and prevent uneven fixation, a 3-percent solution of acetic acid is used. If the stop bath is not used, the developer carried over with the film not only increases the exhaustion of the fixer, but it might cause reduced processing uniformity or stain formation in the radiograph.

6.4.10.1.3 Fixer. After development and stop bath neutralization, the emulsion still contains unreduced non-image forming silver halide, which is detrimental, especially to the radiograph as viewed by transmitted light. The fixer is used to remove the unreduced silver halide.

6.4.10.1.3.1 The most common fixing baths are solutions of sodium thiosulfate. Ammonium thiosulfate is also used when quick fixation is required. These chemicals possess activity that converts silver halides to soluble compounds. The emulsion which is softened by the developer is hardened by the fixer. Almost all fixers in use today are of this acid hardening type.

6.4.10.1.4 Wash Accelerator or Quick Washing Agent . Film removed from the fixing bath retains not only the fixer ingredients, but also other compounds that were formed in dissolving the silver halides. To remove these, the film is washed in running water for 20-minutes or more. Some manufacturers offer an agent to reduce the washing time to one-third or one-fifth the time required without its use.

6.4.10.1.5 Wetting Agent. After the wash step, water adheres to the film in streaks and drops. If the film is dried in this condition, not only will the drying time be extended, but water marks will be left on the surface of the radiograph.

6.4.10.1.6 Other Processing Chemicals. In addition to the chemicals discussed above, certain chemicals MAY also be used on finished radiographs to alter densities. When the density of the silver image is too high, a chemical solution called a reducer is used to reduce it. When the density of the silver is too low, a chemical called an intensifier is used to increase it.

6.4.10.2 Chemicals for Automatic Processing.

CAUTION

Medical automatic processing chemicals are formulated to function at high temperatures, but are not capable of producing acceptable industrial radiographic results. Only development chemicals formulated to be used to develop industrial radiographic film SHALL be used in industrial radiographic film processors.

The composition of chemicals formulated for use in automatic processors differs somewhat from chemicals used in hand processing. The most pronounced difference is automatic processing chemicals protect the film against mechanical pressure and roller stains. The developing solution contains a hardener, in addition to its constituents, to inhibit excessive softening of the emulsion. Softening of the emulsion interferes with the transport of the film through the processor. Automatic processing chemicals are specially designed for use at high temperatures. Chemicals for use in automatic processor are supplied in concentrated liquid form, and a starter system is adopted for ease of use.

6.4.10.2.1 Automatic Processing Chemical Requirements . Here are the major requirements that automatic processor chemicals must meet.

6.4.10.2.1.1 Rapid Reaction and Activity Recovery . In automatic processing, development and fixing must each be completed within the time frame of 1 to 2.5 minutes. To give constant results, processing solutions must provide for quick recovery of working strength, when replenished at rates proportional to the quantity of film processed.

6.4.10.2.1.2 Suitability for High Temperature Processing. As processing solutions are maintained at high temperatures, they must be formulated so performance will not be adversely affected by elevated temperatures.

6.4.10.2.1.3 Extended Performance Maintenance. Processing solutions are generally used in automatic processors over a long period of time without being replaced. Throughout this period, the processing solutions must show constant performance, without harming the tanks, racks, and films.

6.4.10.2.2 Automatic Processing Developer. In the roller transport type automatic processors for industrial X-ray films, processing solutions are used at higher temperatures (e.g., 86°F or (30°C)) than in manual processing in order to speed the process. Many transport rollers are used to squeegee the film and remove the exhausted solutions from the surfaces. Developers used in automatic processors are specifically formulated to be suitable for processing at high temperatures and include special chemicals which adjust the contrast and fog. A hardener is included to harden the emulsion, thus, providing sufficient resistance to the forced roller squeegee effect.

6.4.10.2.3 Automatic Processing Fixer. The fixer used in roller transport type automatic processors is especially formulated to produce a greater emulsion-hardening effect than with the fixer used in manual processing. Developer tank transport rollers reduce the amount of developer carryover to the fixer. This extends the life of the fixer, although the primary function of the rollers is to move the film through the processor.

6.4.10.2.4 Chemicals NOT Required in Automatic Processing.

6.4.10.2.4.1 Stop Bath - The stop bath is not used in roller transport type automatic processors, because the rollers adequately remove developer solution from the surfaces of the film. This prolongs the life of the fixer to a far greater extent than in manual processing.

6.4.10.2.4.2 Wash Accelerator - In roller transport type automatic processors, the fixer tank rollers efficiently remove fixer from the film surfaces and wash tank rollers provide for continual turnover of fresh water on the film surface; therefore, the necessity of a wash accelerator is not required.

6.4.10.2.4.3 Wetting Agent - In roller transport type automatic processors, the rollers effectively remove the wash water clinging to the surfaces of the film so a wetting agent is not needed.

6.4.10.3 Mixing Radiographic Chemicals. All mixing vessels SHALL be made of either polypropylene, enamelware, stainless steel, glass, hard rubber, or glazed earthenware. Metal containers such as aluminum, iron, and zinc will contaminate the solutions and result in fogging on the developed radiograph and therefore, SHALL NOT be used. Chemicals SHALL be mixed thoroughly in accordance with the manufacturer's instructions.

6.4.11 Processing Radiographic Film. This section will deal with manual processing first and automatic processing second.

6.4.11.1 Manual Film Processing.

6.4.11.1.1 Developer.

CAUTION

Developer solution SHALL NOT be allowed to drain back into the developer solution tank. The developer solution that is draining becomes oxidized and reduces the useful life of the working bath.

6.4.11.1.1.1 Developer Solution. Manufacturers make developers in standard powder and liquid forms. These developers commonly use three reducing agents, metol, phenodone, and hydroquinone. A combination of these ingredients produces all of the steps of grays and jet black, bringing out the best possible results.

6.4.11.1.1.1.1 Metol or phenodone and hydroquinone will not develop when used alone. To produce any density on the film also requires an alkaline solution. The alkali in effect “opens the door” and permits the developing agents to enter the pores of the emulsion. The speed with which the “door opens” is determined by the amount and potency of the alkali. If too much alkali is present, the developer will tend to produce chemical fog. But, if too little is used, developing will be retarded. Within these limits, the stronger the alkali, the more rapidly development will be completed. Some of the alkalis used in developing solutions are sodium hydroxide, potassium hydroxide, sodium carbonate, potassium carbonate, and borax.

6.4.11.1.1.1.2 Developing solutions containing only the developing agents and alkali would rapidly be exhausted by oxidation from the air. The life of all developing agents is limited by: 1) the reduction of silver bromide to metallic silver, and 2) the amount of oxygen absorbed by the developing agents from the air. There is, however, a chemical whose inclusion in developing solutions extends its useful life. This chemical, sodium sulfite, along with oxygen, have a natural attraction for each other. The affinity is so great when added to a developing solution, sodium sulfite actually prevents oxidation by air of the other components for limited periods of time. To assist in reducing oxidation of developing and fixing solutions the following SHALL apply:

- Use a replenishment tank with a floating lid, which matches the general configuration of the container. The floating lid SHALL be manufactured from a material that will not react with the processing chemistry. It SHOULD also have a specific gravity less than the chemistry so it will float naturally. One material that has these characteristics is “polypropylene.” The floating lid SHALL be used in conjunction with the dust cover lid that fits over the top opening of the container.
- Only enough chemical that WILL be consumed within a one-week period SHALL be mixed.
- Developing solutions which are not mixed for use or replenishment SHOULD be maintained in their sealed, original manufacturer’s containers.
- Developing solutions SHALL NOT be used two-years past the date of their manufacture.

6.4.11.1.1.1.3 As stated earlier, all developing agents have a tendency to deposit silver in the unexposed parts of the film emulsion after a certain period of time. This tendency may be retarded or restrained if bromide is added to the solution, in- other-words, this may slow development. The proportion of bromide in an X-ray developer SHOULD be just enough to prevent chemical fog without materially reducing the activity of the solution. Remember, bromide is removed from the film emulsion during development; therefore, since bromide is a restrainer, it SHOULD be evident as each piece of film is developed, more restrainer is being added to the solution. Additionally, developing agents gradually lose potency as they age and/or are used. Consequently, as each piece of film is processed, developing time for the next film must be theoretically increased. The most important characteristic of any developing formula is its ability to produce and reproduce a certain degree of film blackening for a particular quantity of absorbed X-ray energy. Consistency and stability can only be secured by maintaining constant developer activity. To achieve the stability required, the developing solution SHALL be tested and replenished per process control requirements and manufacturer’s instructions.

NOTE

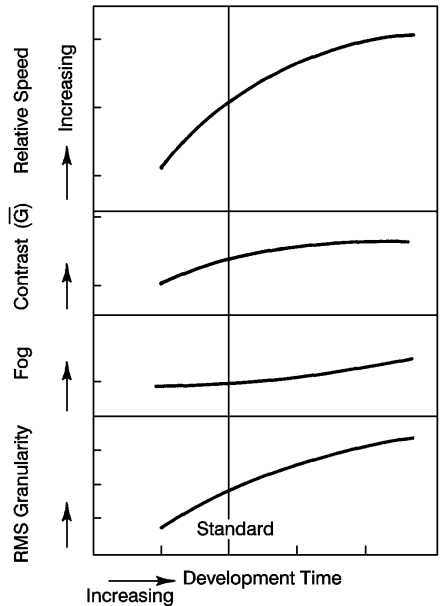
Whenever process control requirements and manufacturer’s instructions are in conflict, the process control requirements within this technical manual SHALL take precedence.

NOTE

For consistent results, the various parameters of development must be kept constant.

6.4.11.1.1.2 Developer Temperature. The image density and contrast of a radiograph are influenced by development temperature and time. It is necessary to keep the developer at a specified temperature (normally 68°F/(20°C) for manual processing) and carry out development during a specified time. When the temperature of the developer is higher than normal, the sensitivity, resolution, and contrast of the developed film will be reduced similar to the results obtained by extending the development time, and vice versa. With the reduction of these preferred qualities, latitude and fog level will increase, decreasing the usefulness of inspection results. In any case, it is important the temperature of the developer be kept within a range from 64.4° to 73.4°F (18° to 23°C). Because development time varies with each brand of developer, the instructions given by the manufacturer SHALL be followed.

6.4.11.1.1.3 **Development Time.** The sensitometric properties of X-ray film change when the development time is changed while maintaining constant levels for other conditions, such as temperature and agitation. X-ray film speed and contrast increase to a certain extent with increasing development time, but contrast could fail due to fog or other causes. The graininess might become coarser when development time needs to be extended to increase speed and contrast. A maximum limit of 8-minutes SHOULD NOT be exceeded at a developer temperature of 68°F/(20°C) (Figure 6-38). Film SHALL NOT be left in the developer solution any longer than the prescribed time for its specific temperature (Table 6-14). Uncontrolled time and temperature during film development will cause under or over development, which reduces or eliminates useful information from being discernible on the radiograph. Developing solutions, which pass their useful life, SHALL be disposed of properly. Check state and local regulations to determine proper method of disposal.



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Figure 6-38. Development Time Related Photographic Properties of X-ray Film

Table 6-14. Developing Time Versus Temperature

Time (Minutes)		Temperature (°F)
Normal	Maximum	
3-1/4	6-1/4	80
3-3/4	6-3/4	76
4	7	72
4-1/2	7-1/2	70
5	8	68 (Recommended)
5-1/2	8-1/2	65
6	9	63

6.4.11.1.1.4 **Developer Agitation.** During development, the developer solution or the hanger loaded with exposed film is agitated at frequent intervals in order to keep the emulsion in contact with fresh solutions at all times, thus accomplishing even development. If films are allowed to develop without any movement, there is a tendency for each area of the film to affect the development of the areas immediately below it. This is because the products of development have a higher specific gravity than the developer. The greater the film density from which the reaction products flow, the greater is the restraining action upon the development of lower portions of the film. The solution in contact with high density areas of the film will be locally exhausted so development of those areas stops, while the solution in contact with low density areas is

exhausted to a lesser extent so development proceeds. As a result, such a radiograph will show low contrast. Thorough and even agitation of the film during development is very important. When tray processing is used, care SHALL be taken to assure radiographs do not cling to one another, and the tray SHALL be rocked to provide continual mixing and redistribution of the solution.

6.4.11.1.1.5 Developer Exhaustion and Replenishment . If the water volume is not accurately measured in the preparation of developer solutions, the resulting properties will vary from the original specifications and fog could result. Accurate measurement of water volume is therefore important, however, it SHOULD be remembered the development capacity of even an accurately prepared developer solution decreases as it is used. It is necessary to check the developer solution for exhaustion by maintaining records of the sizes and quantities of X-ray films processed and the number of days the developer has been used.

6.4.11.1.1.5.1 To obtain uniform radiographic results over a period of time, it is necessary to check the activity of the developer solution and add developer replenisher in proportion to quantity of film processed or at regular intervals. The extent to which the developer replenisher influences the sensitometric properties of X-ray film is demonstrated in [Figure 6-39](#). The rate of replenishment varies with the size and quantity of films and their average density. The developing power of the developer decreases with increasing density or film size, and vice versa. The relative areas of various size films as determined by assigning the value 1 to the reference size 10 x 12 inches (25.4 x 30.5 cm) are shown in [Table 6-15](#).

NOTE

In order to reduce variations in developer solution activity and achieve uniform radiographic results, replenisher SHALL be added in small quantities and at frequent intervals.

Table 6-15. Film Size Versus Relative Area

Film Size	Relative Area
35.6 x 43.2 cm (14 x 17 in.)	2
25.4 x 30.5 cm (10 x 12 in.)	1
11.4 x 43.2 cm (4-1/2 x 17 in.)	0.6
8.5 x 30.5 cm (3-1/3 x 12 in.)	0.3

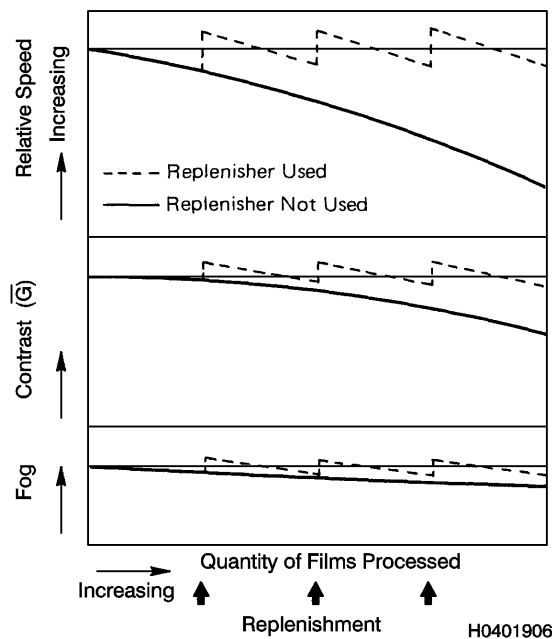


Figure 6-39. Effects of the Developer Replenisher on the Properties of X-ray Films

NOTE

It is recommended radiographic inspection facilities use the replenishment method while performing the manual film development process.

6.4.11.1.1.6 Developer Aging. As films are developed without replenishment, the developing solution becomes exhausted chemically until no developing action can take place. For a given quality of developer, without considering the effects of oxidation, levels of bromide, hardener, and contamination, the development time must be increased for successive films to fully develop them. It is estimated a five-gallon tank of developer will develop 140 films, size 35.6 x 43.2 cm (14 x 17 in.), satisfactorily without excessive increase in development time. It is convenient to divide the total number of films that can be developed by 5-gallons of developer into seven groups of 20 films each. As each group of 20 films, 35.6 x 43.2 cm (14 x 17 in.), or equivalent film area is developed, the development time must be increased 1/4-minute, assuming a normal time of 5-minutes at 68°F (20°C). Even when drained, each film carries about 1-1/2-ounces of developer with it, so developer must be added to keep the tank at the 5- gallon level. When the specified number of films has been developed, discard the solution. This method is known as the exhaustion method of developing.

6.4.11.1.1.6.1 Another method of processing is the replenisher method. By adding replenisher solution periodically, the activity of the developer is kept at the same level. In this method, films must be removed from the tank quickly without allowing the excess developer to drain off the film back into the tank. Approximately 1-gallon of replenisher SHOULD be added for every 40 films, 35.6 x 43.2 cm (14 x 17 in.), or equivalent film area (based on 5-gallons of developer). If this amount of developer cannot be added at the specified time, too much developer is draining back into the tank. In this case, enough developer must be drained from the tank so the replenisher can be added. For dense radiographs it MAY be necessary to increase the quantity of replenisher added. In this case, it is also desirable to add replenisher at shorter intervals to keep the level of developer activity more nearly constant.

NOTE

The developer solution SHALL be discarded when the replenisher used equals four times the original quantity of developer solution, when it fails the process control requirements or at each two month period, whichever occurs first.

6.4.11.1.1.6.2 Fresh developer is referred to as “wild” and will often result in excessive contrast on the first few films. This is apparently due to the lack of equilibrium between the developer and the reaction products. It is sometimes recommended a small quantity of old developer be mixed with the fresh developer to temper the solution.

6.4.11.1.2 Stop Bath.

WARNING

Glacial acetic acid SHALL be handled with adequate ventilation, and great care SHALL be used to avoid injury to the skin or clothing. Glacial acetic acid SHALL always be slowly added to water, while stirring constantly. Water SHALL NOT be added to the acid, since this may cause boiling, splattering acid, causing burns to the hands or face.

6.4.11.1.2.1 Stop Bath Solution. The stop-bath consists of a mild glacial acetic acid solution, designed to neutralize the alkali of the developer. Developer solution will contaminate the stop-bath, but much of this contamination can be eliminated by allowing the radiograph to drain for one or two seconds prior to placing it in the stop-bath.

NOTE

Stop-bath SHOULD be used during hand developing radiographic film, when allowed by the operational environment.

6.4.11.1.2.2 Stop Bath Function. The function of the stop bath is to nullify the action of the developer through the use of acetic acid. It stops development in the shortest period of time to prevent uneven development and subsequent streaking

on the film. Therefore, it is important to assure the action of the developer is terminated over the entire surface of the film. The stop-bath also protects the fixing solution, which is slightly acidic, from the alkalis of the developer, thereby extending its useful life.

6.4.11.1.2.3 Stop Bath Temperature. Care SHALL be exercised to prevent a rapid change in the extent of swelling in the emulsion layer. To meet these requirements, the stop bath SHALL be maintained at a constant temperature close to that of the developer solution. If the temperature of the developing solution is 68°F (20°C), the temperature of the stop bath SHALL be maintained within the range of 59° to 68°F/(15° to 20°C). If sodium carbonate is used to formulate the stop-bath, it SHALL be used between 65°F (18°C) and 70°F (21°C); otherwise, it will cause carbon dioxide blisters to form in the film's emulsion.

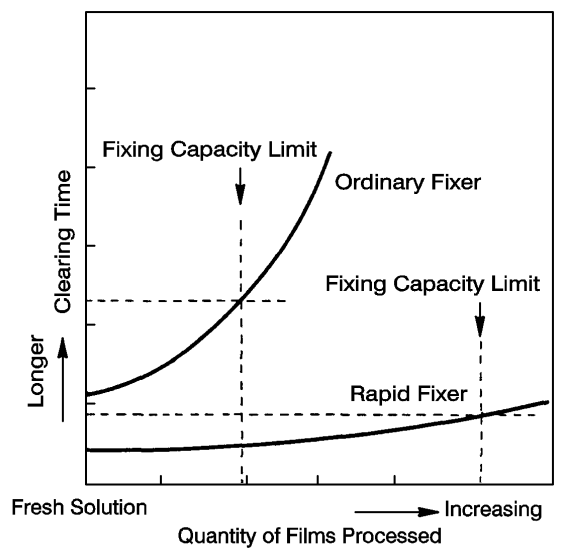
6.4.11.1.2.4 Stop Bath Agitation. After the film is placed in the stop bath, it SHALL be continuously agitated for about 15-seconds to prevent uneven development. Ensure films do not cling to one another, and immerse films in the stop bath for 1-2 minutes, agitating about every 30-seconds.

6.4.11.1.2.5 Stop Bath Exhaustion and Replenishment. The stop bath is checked for exhaustion with a pH meter or litmus paper. When the pH of the stop bath exceeds 6.0, its neutralizing power has decreased to such an extent it no longer is able to perform its proper function. Make it a rule to replace the stop bath when its pH value is close to the critical level of 5.5. If a stop bath cannot be prepared for one reason or another, a fresh running water rinse MAY be used in place of the acetic acid stop bath.

6.4.11.1.3 Fixer.

6.4.11.1.3.1 Fixer Solution. There are only two chemicals in common use that will act as clearing agents by dissolving the undeveloped silver bromide in thin film emulsion. These are 1) sodium thiosulfate (hypo) and 2) ammonium thiosulfate. Weight-for-weight, ammonium thiosulfate has approximately three-times the fixing power of sodium thiosulfate. It is the clearing agent in liquid high-speed fixing concentrates, while hypo is used in regular-speed formulas.

6.4.11.1.3.1.1 When a solution of ammonium thiosulfate is used as a fast action fixer, not only is the film cleared in a shorter time, but twice the fixing capacity of ordinary fixer solutions is made available. The fixing capacity limit is likely to be exceeded more easily with fast acting fixer solutions because the time to clear is short, even when twice the fixing time needed by a fresh solution is required. Fast acting type fixers are not recommended for general use because they could cause discoloration or image fading. Clearing times and fixing capacities for ordinary and fast-acting fixers are compared in [Figure 6-40](#).



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Figure 6-40. Clearing Time and Fixing Capacity of Fixers

6.4.11.1.3.1.2 It is essential the fixing solution neutralize the alkaline developer adhering to the film. In other words, development must stop before fixing can begin. The neutralizer is an acid; the most suitable of which are acetic and sulfuric acid in weak concentration. If a fixing bath is to be used for a long period of time, a large quantity of acid is necessary to neutralize the alkalinity of the developer. Fixing is accomplished by means of the thiosulfate only.

6.4.11.1.3.2 Fixer Function. After development, the emulsion contains all of the unexposed and undeveloped grains of silver. A permanent image cannot be retained in the exposed and developed X-ray film unless it is treated with the fixer. The undeveloped silver must be removed from the emulsion if the image is to be permanent. Fixing conditions greatly influence the degree of radiographic permanency. Therefore, control of these conditions, as described below, needs to be addressed.

6.4.11.1.3.3 Fixer Temperature and Fixer Time . The fixer temperature does not influence the fixing speed to the same extent the developer temperature affects development time, but generally, fixing time decreases with an increase in fixer temperature. The relationship between the fixer temperature and the fixing time is shown in [Figure 6-41](#). The fixer temperature SHALL be adjusted to be in close range of the developer temperature to avoid related detrimental effects on the emulsion.

6.4.11.1.3.3.1 As a general rule, fixing requires twice the time that elapses from the moment the film is immersed in the fixer solution to the time the milky emulsion becomes completely transparent. If the fixing time is inadequate, the film retains some insoluble salts (complex silver thiosulfate compounds). If they are allowed to remain, they will react with the environment and degrade the image, causing it to discolor and fade. Even if the fixing exceeds twice the clearing time, the quality of the processed radiographs will not be adversely affected. On the other hand, if the film is allowed to remain in the fixer solution for too long a time, the density of the image will decrease and the film will acquire a brown color. Granularity might also be affected depending on the circumstances. Films SHALL NOT be left in the fixing bath for an excessive period of time.

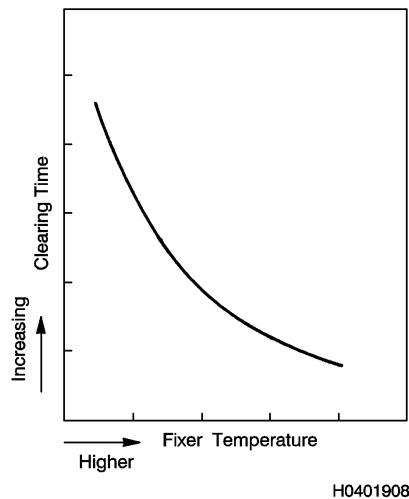


Figure 6-41. Fixer Temperature-Time Curve

6.4.11.1.3.4 Fixer Agitation. When the film is first transferred from the stop bath into the fixing bath, it SHALL be agitated continuously for 10-seconds and thereafter occasional agitation is to be employed. Ensure films do not cling to one another. If the stop bath is unavoidably skipped (the skipping of the stop bath SHALL be avoided to prevent uneven development), and the film is directly transferred from the developer solution into the fixing bath, or if the film is rinsed after development and transferred into the fixing bath, it SHALL be agitated vigorously in the fixer for about 30-seconds. If agitation is not vigorous enough, uneven fixation may result and dichroic fog and stains may occur when the fixer solution is exhausted. Dichroic fog is likely to start from the presence of traces of developer in the fixing bath. When viewed by transmitted light, film with dichroic fog has yellowish to brownish stains. These stains are of a bluish, greenish, or yellowish metallic luster when viewed by reflected light.

6.4.11.1.3.5 Fixer Capacity. In general practice, the fixer solution is not replenished and is used until fully exhausted. As it is used, its fixing capacity decreases to a point at which the time required for the film to clear is increased by twice the time

required with fresh fixer solution. When this critical state has been reached, the fixer solution SHALL be replaced. If this limit is exceeded, proper fixation will not be accomplished even if the film remains in the fixer solution longer than twice the clearing time. Such practice will further result in image discoloration or fading.

6.4.11.1.3.5.1 During use, films carry the processing solution into the fixing bath. The amount of processing solution carried on the film has a significant effect on the strength of the fixer solution exhausting it over time. The smaller the carry-over, the less the fixer solution will be degraded. If film is to be drained thoroughly, it must be held out of solution for a long period of time, and such exposure to air brings with it the risk of discoloration. Films, wet with any of the processing solutions, SHALL NOT be allowed to remain in contact with the air for longer than 10-seconds.

6.4.11.1.3.5.2 When films are repeatedly transferred directly from the developer solution into the fixing bath, or rinsed and transferred into the fixing bath without using the stop bath, the hardening capacity of the fixer solution decreases rapidly so films are easily scratched or longer than normal drying times are required after washing. Furthermore, under these conditions, development MAY proceed even in the fixing bath, thus leading to dichroic fog and uneven fixation. In such cases, it is necessary to replace the fixer solution even before complete exhaustion has taken place.

6.4.11.1.3.6 Hardening. Because X-ray film is handled frequently and is subject to more abuse than photographic negatives, it is customary to use a hardening agent. This hardening agent, or "hardener", tans and toughens the emulsion. Some of the common hardeners are "alum" and "aluminum and chloride" for high-speed fixers. One distinct advantage of the hardener used in high-speed fixers is the production of a hardened film, which will not melt in water as hot as 175°F (79.4 °C) after the film is dried.

6.4.11.1.3.7 Clearing Action. When a film is removed from the developing solution, the undeveloped areas are swollen and yellow in appearance. Sometime after immersion in the fixer, this yellow becomes transparent; this change MAY be observed and recorded. The time required for this change is known as the "clearing time." To adequately fix a film, it SHALL be immersed in the fixer at least twice as long as it took to clear. This period SHALL NOT exceed fifteen minutes. For example, if the clearing time is two-minutes then the fixing time is four-minutes. The fixing solution will become deficient with each use. This deficiency is insidious, and MAY be overcome by adjusting the fixing time up to the maximum fifteen-minute time period. The cause of the fixer degradation may be due to one or more of the following:

6.4.11.1.3.7.1 The accumulation of soluble silver salts will gradually prevent the fixer from dissolving unexposed silver halide from the film emulsion, therefore, making the fixer incapable of properly clearing the radiographic film.

6.4.11.1.3.7.2 The loss of chemical activity is evident when long periods of time are required to clear a radiograph. This situation will cause colored stains on the radiograph, swelling of the emulsion that inhibits hardening and results in long drying times, and reticulation or sloughing during drying.

6.4.11.1.3.7.3 Reduction of activity caused by dilution of the fixer solution when stop bath, rinse water, and developer solution are carried over by the film being processed. The effects of this dilution/contamination are reduced by allowing the radiograph to drain into the stop bath prior to being put in the fixer. Care SHALL be taken to not contaminate the developer solution.

6.4.11.1.4 Washing. Thorough washing is necessary to remove the processing solutions and complex silver salts (complex silver thiosulfate compounds). If such salts are allowed to remain after washing, they will gradually decompose and cause the image to discolor or fade. Because hardeners are used in X-ray fixing solutions, it is difficult to remove small quantities of the fixer retained by the gelatin.

6.4.11.1.4.1 Wash Water Flow Rate and Temperature . The faster the flow of water in contact with the emulsion, the faster the undesired compounds are removed and the shorter the washing time becomes. The wash water temperature SHOULD preferably be slightly lower than the fixer temperature to avoid adverse conditions in emulsion. In practice, however, considerable capacity is required to maintain adequate control of wash water temperature. Ideally, the developer temperature SHOULD be 68°F/(20°C) and the wash water temperature varies greatly with the season. If such variations are present, there is no alternative but to make slight changes in the stop bath and fixer temperatures in favor of the wash water temperature, as shown in [Table 6-16](#).

Table 6-16. Examples of Temperature Adjustments for Processing Solutions

	Developer	Stop Bath	Fixer	Wash Water
Summer	20°C (68°F)	22 to 25°C (71.6 to 77.0°F)	25 to 28°C (77.0 to 82.4°F)	30°C (86°F)
Winter	20°C (68°F)	18 to 15°C (64.4 to 59.0°F)	16 to 13°C (60.5 to 55.4°F)	10°C (50°F)

6.4.11.1.4.2 Wash Time. The speed of washing is determined by the speed with which the clearing agent diffuses out of the film into the water. The quantity of clearing agent remaining in the gelatin is continually halved in the same period of time as washing continues. For example, if a film gives up one-half its clearing agent in 1-minute, then after 2-minutes one-quarter remains, after 3-minutes one-eighth, in 4-minutes one-sixteenth, and so on, provided the film is continually exposed to fresh water. Washing will never remove all traces of fixer. The object of washing is to remove enough fixer so the film MAY be maintained without fading for any given period of time. The processed film SHOULD be washed in running water at 68°F (20°C) for 50 minutes or more. For most practical purposes, X-ray film will be washed sufficiently in 30-minutes if the water changes at the rate of four to eight-times per hour (Table 6-17). The wash water temperature SHOULD be between 65°F (18 C) and 80°F (26 C) temperature values for F values. Regardless of the type of fixer used, if the film is allowed to fix twice the required time, three times a normal washing time is required.

Table 6-17. Manual Washing of Radiographic Film

Manual Approximate Film-Washing Times at 68°F		
Class of Film	Rate of Water Change	Washing Time
I	4 times per hour	35 minutes
I	8 times per hour	20 minutes
II	4 times per hour	35 minutes
II	8 times per hour	20 minutes
III	4 times per hour	35 minutes
III	8 times per hour	20 minutes
IV	4 times per hour	35 minutes
IV	8 times per hour	20 minutes

6.4.11.1.4.2.1 If the temperature of the wash water falls below 50°F (10°C), it is not possible to adequately remove the fixer from the emulsion in the above length of time. Washing takes three-times as long when the temperature is between 50 to 60°F (10 to 16°C) as it does at 70°F (21°C) to 75°F (24°C). Thus, the rule for washing time for X-ray film is true only when the wash water is relatively warm. If the film has been over fixed, and then washed at 50°F (10°C), there is no practical way to remove enough fixer to prevent fading of the image. In addition, if the temperature difference between fixer and wash water exceeds 15°F (-9°C), there is a possibility of unequal swelling of the emulsion known as reticulation.

6.4.11.1.4.3 Wetting Agent Action. The use of a wetting agent between the washing and drying operations is highly recommended. When the film is removed from the wash tank, small drops of water will cling to the emulsion. Areas under these drops will dry more slowly and cause distortion of the gelatin, changing the density of the silver. These are frequently visible and can be troublesome in film interpretation. Most water also contains large amounts of solid material in the form of calcium and other chemicals, which will remain on the film as a white residue after the water drops have evaporated. Such “water-spots” can be prevented by immersing the washed film in a wetting agent for one to two-minutes before transfer into the drying cabinet. Various detergents or commercial wetting agents can be used.

6.4.11.1.5 Drying. The final step in processing is drying of the X-ray film. Film SHALL be dried immediately after washing. Water streaks and drops adhere to film surfaces and if they are not removed prior to drying, the areas lying underneath will dry more slowly than the surrounding areas thus, changing the density of the silver image and resulting in spots. Such uneven drying can be prevented by gently wiping the film with a sponge or accelerated if the film is immersed in a wetting agent solution following washing. In addition to speeding drying time, this technique also prevents the formation of water-marks or streaking on the emulsion. Hang up the films in a dry rack where the film hangers can be suspended. Where a large

number of films must be handled, special equipment may be necessary. The forced air dryer SHOULD have a filter over the air inlet with the unit providing 104 to 122°F (40 to 50°C) hot air movement over the film.

6.4.12 Manual Film Processing Procedure.

6.4.12.1 Preparation.

- a. Be sure all films are placed on hangers properly.
- b. Check the temperature of all processing solutions using a bimetallic thermometer ([Table 6-17](#)).
- c. Agitate the developing chemicals and make sure they are at the proper level; replenish if necessary.
- d. Be sure wash water flow is adequate.

6.4.12.2 Step-by-Step Manual Processing Procedure.

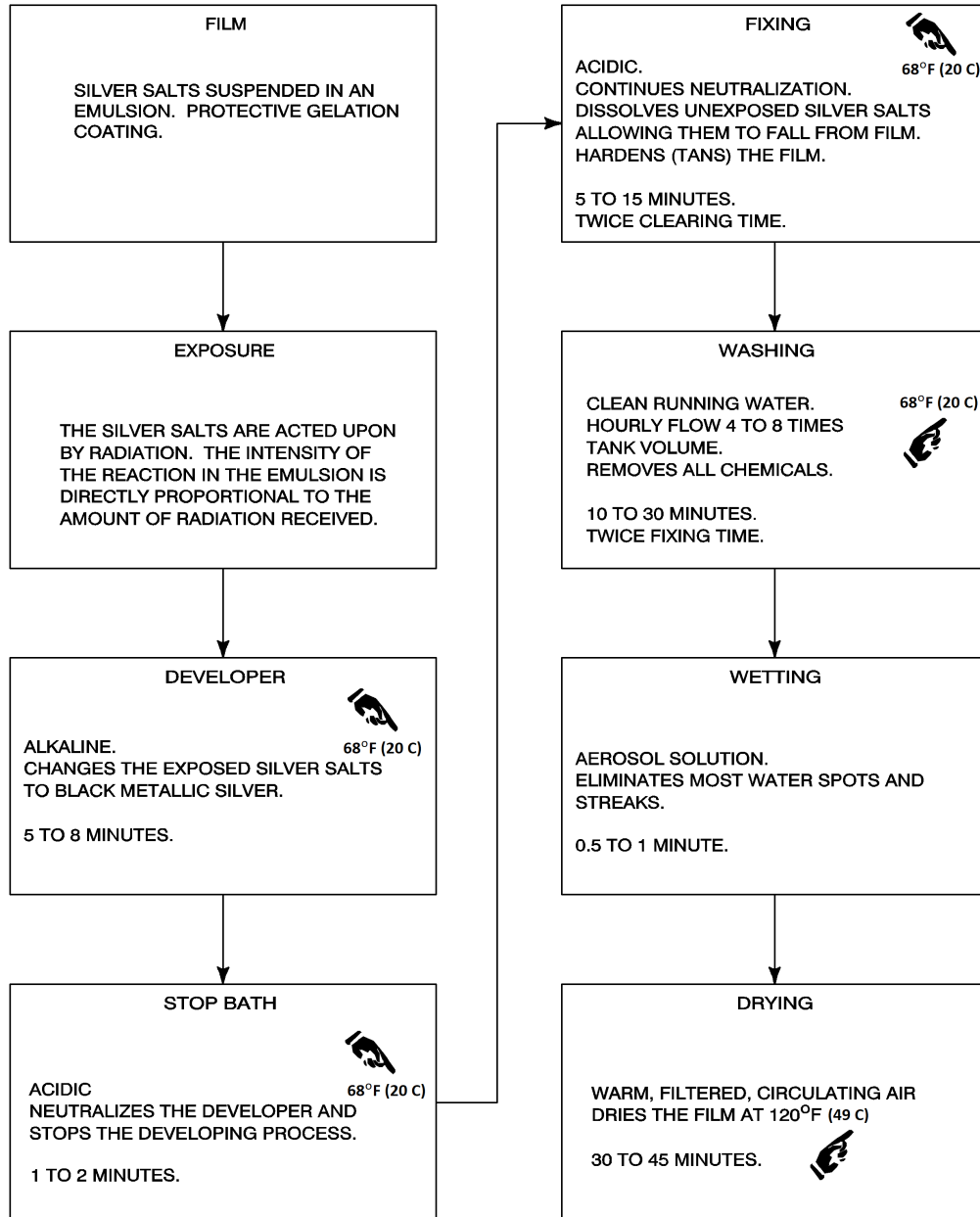
CAUTION

Films SHALL NOT be allowed to remain out of solutions for more than 10 seconds since this will cause uneven development.

NOTE

Drain the films and hangers for several seconds between operations to prevent carryover of chemicals from one tank to another.

Refer to [Figure 6-42](#).



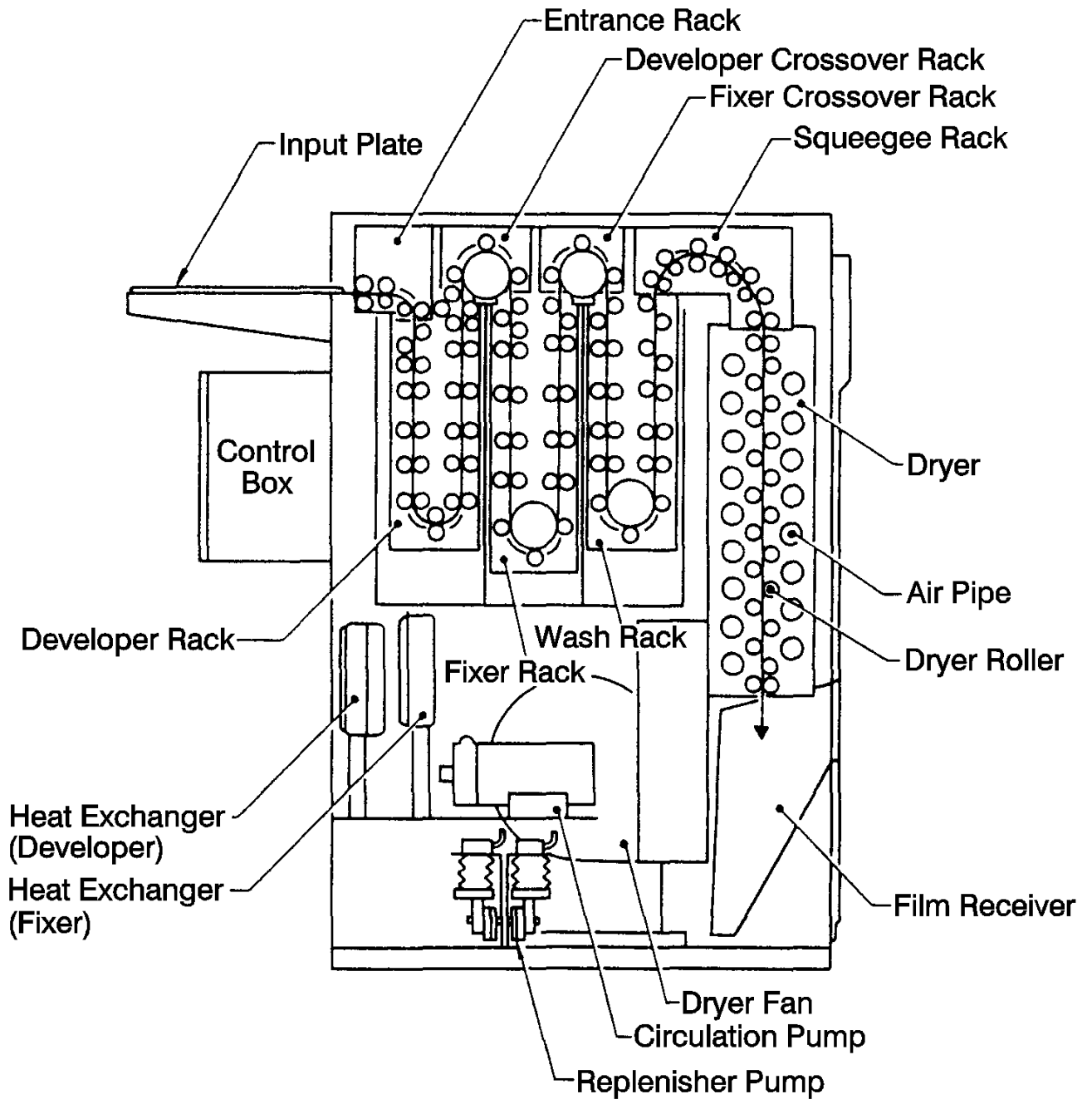
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Figure 6-42. Manual Film Processing

- a. Immerse the films (and hanger) in the developing solution. Agitate the hangers by hand at 30-second intervals. This SHALL be done during the entire developing time.
- b. Remove the films from the developer and immerse in stop bath for approximately 1 - 2 minutes.
- c. Remove the films from the stop bath solution and immerse in the fixing solution. The total “clearing time” SHALL be determined according to [Paragraph 6.4.11.1.3.7](#).

- d. Remove the films from the fixing bath and immerse in the wash water for the recommended period.
- e. Dry the films.
- f. Remove the films from the film hangers.

6.4.13 Automatic Film Processing. A system of rollers is generally employed as the transport mechanism in automatic processors, as shown in one manufacturer's sectional view [Figure 6-43](#). Automatic processors decrease dry-to-dry processing time from approximately one-hour, in a manual hand tank system, down to 5 to 13-minutes ([Table 6-18](#)). Furthermore, the automatic processor reduces variations in radiographic quality. However, the processor alone cannot produce these effects unless combined with suitable film and processing chemicals.



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Figure 6-43. Sectional View of Fuji FIP 4000 Processor

Table 6-18. Conditions for Manual and Automatic Processing

	Development	Stop Bath	Fixing	Washing	Finishing Bath	Drying	Total
Manual Processing	20°C/68°F	20°C/68°F	20°C/68°F	20°C/68°F	20°C/68°F	40°C/104°F	
	5 min.	30 sec.	5 min.	50 min.	30 sec.	30 min.	91 min.
Fuji Fip 4000 Processor	30°C/86°F	-	31°C/88°F	31°C/88°F	-	About 45°C/113°F	
	1 min. 35 sec.	-	1 min. 30 sec.	1 min. 30 sec.	-	50 sec.	5 min. 25 sec.

6.4.13.1 Advantages of Automatic Film Processing. In addition to eliminating the variations in radiographic quality, and reducing processing time by 3/4, automatic film processors also take up less space within the darkroom, help to keep the room cleaner and are easily installed. Automatic processing is particularly advantageous when large volumes of film need to be processed. Automatic processing also provides for greater uniformity of development, thus providing more consistent results. The quality level of these results is determined by chemical and equipment condition, and conscientiousness of the operator. However, because the cycle is faster and the chemical temperatures are higher in automatic processing than they are with manual processing, the use of automatic processing will produce a more narrow (high) latitude radiograph and has a noticeable effect on the radiographic technique. Therefore, apparent film characteristics will be significantly altered by the use of automatic processing. As a result, film quality, when automatic processing is used, is generally lower than that which is obtainable with manual processing. However, the advantages of speed of processing, lower manpower requirements, and consistency of development generally are felt to be more important in the decision to use automatic processing.

6.4.13.2 Rapid Access to Finished Radiographs. The following methods are employed in automatic processing to gain rapid access to finished radiographs.

6.4.13.2.1 Raising Processing Solution Temperatures . The chemical reactions are facilitated by applying relatively high temperatures in processing solutions.

6.4.13.2.2 Reinforcing Chemical Solution Supply to Film Surfaces. A fine spray or processing jet is continuously applied to the film surfaces, as solutions are forced to circulate in the processing tanks, keeping them well mixed and maintaining them in agitated contact with the film surfaces. Such methods facilitate chemical reactions between the emulsion and the processing chemicals.

6.4.13.2.3 Increasing Chemical and Film Interaction through Transport Roller Pressure. The film is brought into direct contact with the transport rollers so the rollers not only squeegee the film, but force processing solutions against the film surfaces, thus facilitating chemical reactions.

6.4.13.3 Care in Automatic Processing. In automatic processing, it is very important certain processing conditions be kept constant as indicated in [Table 6-18](#). Processing control SHALL be rigidly practiced by making periodic measurements to avoid variations in solution temperatures, replenishment rates, and wash water flow rates.

6.4.13.4 X-ray Film Requirements for Automatic Processing. Industrial X-ray films designed for automatic processing SHALL meet the following requirements.

6.4.13.4.1 Increased Adaptability to Rapid Processing . In spite of satisfactory development, the radiographic image could discolor and fade with time if fixing, washing, and/or drying are not adequate. Film processed with an automatic processor SHALL meet special requirements not required by film processed by manual systems. For instance, the emulsion layer must be thinner and the emulsion must react with processing chemicals more rapidly.

6.4.13.4.2 Increased Strength of the Emulsion Layer . Rapid processing will serve no purpose if the resulting quality is inferior to hand processing. When solution temperatures are increased, softening and swelling of the emulsion layer is also increased subjecting the film to severe physical conditions and roller pressure. For automatic processing, the emulsion layer of industrial X-ray film must therefore be strong enough to withstand such severe processing conditions.

6.4.13.4.3 Adoption to a Polyester Based Film. It has been many years since flammable cellulose nitrate film base was replaced first with inflammable cellulose acetate then with polyester base materials. Polyester base materials are advantageous because they provide flatness and great strength. Little expansion and contraction take place and the material is not hygroscopic. These advances in a polyester film base are indispensable to rapid film transport in automatic processors.

6.4.13.4.4 Adoption to Chemicals Used in Automatic Processing. The composition of chemicals formulated for use in automatic processors differs somewhat from that of chemicals used in hand processing. For details on chemicals used in automatic processors see [Paragraph 6.4.10.2](#).

6.4.14 Silver Recovery. The value and scarcity of silver makes recovery of it economically feasible. Approximately 80-percent of the silver in the film emulsion is transferred to the fixer solution; the remaining 20-percent forms the radiographic image. Here we will discuss methods used to recover the silver from both the fixer and the film.

6.4.14.1 Recovering Silver from Fixer. The unexposed and undeveloped silver halides in the film emulsion are removed by the fixer solution. Therefore, the exhausted fixer becomes rich in silver content. There are three basic methods of silver recovery from the fixer solution. These are by electrolysis, metallic replacement, and chemical precipitation.

6.4.14.1.1 Electrolysis Recovery Method. When electric current is passed between two electrodes immersed in the silver-bearing fixer, the silver is electronically deposited upon the cathode. This silver can be stripped from the cathode and refined. This method permits re-use of the fixer.

6.4.14.1.2 Metallic Replacement. This method consists of replacing the metallic silver with a less valuable base metal such as iron, zinc, or copper. As an example, if steel wool is inserted into the exhausted fixer solution, the silver in solution is replaced by the iron, and the silver accumulates on the bottom of the container in the form of sludge. The sludge is removed and refined to reclaim the silver. The fixer SHALL be discarded after silver recovery by this method.

6.4.14.1.3 Chemical Precipitation. Silver can be reclaimed from fixer by the addition of certain chemicals to the exhausted fixer. The silver is precipitated out of the solution in the form of a sludge that can be recovered and refined. The chemical reaction generates obnoxious fumes and odors, and separate facilities are recommended for this method of silver recovery. The fixer SHALL be discarded after silver recovery by this method.

6.4.14.2 Recovering Silver from Film. There are two methods used to recover silver from obsolete films: stripping or burning. It is usually more economical to simply market used or obsolete film than to attempt silver reclamation from film on a small scale. Information regarding the Precious Metals Recovery Program (PMRP) is provided in AFI 23-101.

6.4.14.2.1 Stripping. A chemical or mechanical means is used in this method to strip the silver bearing emulsion from the film base. The emulsion is then refined to reclaim the silver.

6.4.14.3 Burning. The second method is burning the film in an incinerator that controls the burning process and the fly ash. The residual ashes are then processed to obtain the silver content.

6.4.15 Film Reproduction Technique. Often duplicate radiographs are required. If it is known in advance that duplicate films are required, it is quicker and more economical to expose two films simultaneously in the original exposure. If lead screen techniques are being used, slight increases in exposure will be required.

6.4.15.1 If multiple copies of an existing radiograph are required, they can be reproduced by contact printing techniques. The duplicate radiograph can be made on a direct-positive film that produces a duplicate-tone facsimile of the original. The film gradient of the duplicating film is -1.0, which means density differences in the original image are faithfully reproduced in the duplicate image. Duplicating film cannot reproduce radiographic density ranges equivalent to originals. But by varying exposure, the density differences can be recorded accurately.

6.4.15.1.1 If duplicating film is not available, it is possible to use medical film designed for use with fluorescent screens. These duplicates are also produced by the direct printing method. However, these films have a special property. While not a positive film, they do undergo reversal with large exposures. That is, they increase in density up to a saturation point after which time they decrease in density with exposure, and thus reverse. It is necessary to expose these films such that reversals occur, and the original image is duplicated. If the original radiograph has a high density, exposures of as much as two-minutes to a photoflood lamp MAY be required. These exposure requirements must be generated for each specific situation; generalization here is not practical.

6.4.16 **Film Artifacts.** An artifact is the product of human error and in the case of film is usually due to mishandling the film in some step in the radiographic process. Here we will discuss some typical artifacts you may run across.

6.4.16.1 **Processing Artifacts.** Chemical spots can occur if any chemicals are splashed, contacted, or transferred by wet fingers to the undeveloped film. Dark spots indicate either water or developer on the film before processing. Light or undeveloped spots indicate the stop bath or fixer has been allowed to contact the film before processing. Stains caused by chemical reactions, over development, or underdevelopment are processing artifacts. Streaks from contaminated hangers are quite common as well as streaks from lack of agitation during the development period.

6.4.16.2 **Handling Artifacts.** Many artifacts are introduced by film handling. Crowfoot static marks can be caused by sliding the film over surfaces, creating an electrical discharge of static electricity, particularly under very dry atmospheric conditions. Half-moon-shaped marks (either dark or light) can be caused by crimping the film, particularly with the thumb, these are often referred to as thumb crimps, handle X-ray film as if it were a piece of wet paper. Scratching of the emulsion when the film is wet and the emulsion is soft is a common artifact.

6.4.16.3 **Exposure Artifacts.** The most common exposure artifacts are caused by excessive pressure applied to the film before, during, or after exposure. Either heavy parts or excessive bending of the film can apply sufficient pressures to the film emulsion as to render it insensitive to exposure. These artifacts usually appear as unexposed areas on the film.

6.4.16.4 **Manufacturing Artifacts.** Artifacts due to the manufacturing process are comparatively rare. On occasion exposed spots or other manufacturing artifacts, such as roller marks or foreign material may occur on the emulsion surface. Artifacts which are commonly encountered, their cause, and any remedial action which SHOULD be taken are shown in [Table 6-19](#).

Table 6-19. Description of Film Artifacts

Condition	Cause	Remedy
1. White or dark areas as results of pressure on emulsion.	Pressure Marks	Handle film carefully; avoid bending when placing in cassette. Do not place heavy objects on exposure holder.
2. Usually dark areas on film of shadow pattern.	Exposure to light	Light leaks in corners of exposure holders. Test film by developing without exposure to X-rays.
3. Black, sharp chicken-track type pattern.	Static Patterns; The result of rapid removal of film from paper cover of film box.	Handle film properly.
4. Mottled effect over complete area on film.	Paper pattern	Remove paper from film when exposing with screens.
5. Spots on Radiograph	Moisture on screen; fixer comes in contact with film prior to development process	Do not allow film to remain in lead screen exposure holders overnight in humid atmosphere; exercise care of film around processing chemicals.
6. Processing streaks	Chemicals not adequately removed from hanger clips; film placed in water without being placed in stop bath; insufficient agitation during development	Follow proper processing procedures
7. Film Scratches	Abrasive material, fingernails and rough handling during loading or unloading	Use care when handling film
8. Crimp Marks	Bending the film abruptly, when loading or unloading in holder; could be from positioning films in tight areas	Use care when handling film
9. Screen Marks	Blemishes on lead screens may become intensified and can create significant indications on film; Dirt on fluorescent screens interferes with light transmission.	Screens should be inspected to ensure they are absolutely clean, smooth and free of any imperfections or foreign matter.

Table 6-19. Description of Film Artifacts - Continued

Condition	Cause	Remedy
10. Delay Streaks	Delay in feeding successive film may result in chemicals drying on automatic processor rollers.	Clean exposed rollers with damp cloth.
11. Developer Scum	Surface on top of developer tank clings to surface of film	Mix solutions thoroughly before processing film
12. White dots on film	Unclean screens	Clean lead screens with steel wool and soap periodically
13. Fuzzy image	Lack of screen contact with film	Ensure screen and film are in full contact with each other.
14. Grainy image	Could be grain pattern of some high temperature alloys	Certain high temperatures are associated with grain patterns at voltage range of 150 to 250 kV. This condition is eliminated at higher voltages
15. Surface of film is discolored when viewed by reflected light	Dichroic (chemical) fog.	Change developer and short-stop since this condition is usually the result of exhausted solutions.
16. Spots on illuminator appear as dark areas on radiograph.	Dirt on the illuminator	Wipe illuminators periodically with damp cloth
17. Unexplained shadowed area on film	Non-uniform light pattern from illuminator.	Change lamps to correct filament pattern or select fluorescent lamps to match in light response.
18. Foggy film	Use of film beyond expiration or inadvertent exposure to radiation	Protect films from radiation by lead-lined film chest. Use film before expiration. If questionable, check film by processing before exposure.
19. Unexplained pattern of hinges	Back scatter pattern of cassettes.	Back up cassette with lead blocking to prevent scatter from cassette or other surfaces.
20. Puckered or net-like linkages	Reticulation, Film processed through extreme temperature changes.	Maintain all processing solutions and wash water at approximately same temperature.
21. Blisters	Reaction between alkaline developer and acid fixing bath	Maintain correct solutions by following manufacturer's directions.
22. White blotches on film	Water on screens	Dry screens. Do not use for 24 hours
23. Water sports	Results of splashing water on films after they are dried	Handle film in dry area of darkroom. Completely remove from processing section. Do not remove film from hangers until dry under clips.

6.4.17 Special Radiographic Techniques.

6.4.17.1 Introduction. The previous sections of this chapter have primarily been concerned with conventional film radiography. While film radiography offers a versatile tool for the detection and identification of material discontinuities, there are a variety of special radiographic techniques that MAY be employed to extend the capabilities of conventional radiography. Special radiographic techniques are placed into two broad categories.

6.4.17.1.1 Special Purpose Techniques. This category relates to radiographic techniques which require the capabilities of an inspection method to extend beyond normal parameters for a specific objective. This category includes such techniques as "multi-thickness," "multiple film," "triangulation," "thickness measurement," "stereo (three-dimensional)," and "geometric magnification."

6.4.17.1.2 Special Imaging Methods. This second category relates to special methods, such as: "radioscopy," "image intensifiers," "X-ray vidicon," "stereo radioscopy," "photo-radiography," "Polaroid radiography," "photothermographic film," "computed tomography (CT)," and "neutron radiography." Special radiographic methods not included in authorized inspection manuals, SHALL NOT be used without written approval of the appropriate depot engineering activity.

6.4.17.2 Special Purpose Techniques.

6.4.17.2.1 Multi Thickness Techniques. Many situations require radiography of parts with varying thicknesses, and sometimes these may be made of two or more materials. If concentration on one area with a nearly constant thickness is all that is required, optimization of image density is straightforward. However, it may be necessary to obtain an acceptable exposure for two or more varying thicknesses using the same radiographic image. For example, small thickness variations of 0.8 to 0.6 inches can lead to large variations in density ranging from 1.2 to 1.7 respectively. The goal is to ensure all areas of interest have densities not so low as to lose film contrast, and not so high they cannot be evaluated. An acceptable range of densities is 1.0 to 3.5. The procedure recommended during technique development is to identify the thickest area of interest, and then, from exposure charts and trial-and-error, determine the exposure and kilovoltage that provides a density of 1.0. A trial exposure will then show the density of the image of the thinnest area of interest. There are three possible courses of action an inspector can take:

6.4.17.2.1.1 If the density of the thinnest section of the image is approximately 3.5, and the image can be satisfactorily interpreted, the technique is optimized.

6.4.17.2.1.2 If this density is too low, the exposure SHOULD be increased to raise the average density of thick and thin areas.

6.4.17.2.1.3 If the density of the thinnest section is too high, the range of thicknesses is too great for satisfactory imaging. One possible solution is to raise the kilovoltage substantially, as this reduces contrast of thin areas. A better (and more common) solution is to load the cassette with two films of different speed and expose them simultaneously. This technique is commonly known as “multi-film or double-loading.” In the latter case, care is required to ensure that an acceptable image density is obtained for all areas of interest.

6.4.17.2.2 Multiple Film Techniques. Multiple film techniques (commonly known as double-loading) permit the inspection of parts with multiple thicknesses using a single radiographic exposure. Since a major expense associated with radiographic inspection can be attributed to setup, it may be desirable to expose a multi-thickness component in a single exposure, rather than set up an exposure for each cross section of the component. Using multiple film techniques allow this to be achieved.

6.4.17.2.2.1 An example of this technique is to load a cassette with both a Class 1 and a Class 3 film to provide wide latitude. The faster Class 3 film provides a readable density film for the thicker sections of the component, while the slower Class 1 film provides the appropriate film density for the thinner sections of the component. Thus, in a single radiographic exposure, two images with varying density will be generated covering the required latitude for the inspection of a multi- thickness component.

6.4.17.2.2.1.1 If a part has even more complexities than what was described in the previous paragraph, it is possible to use three classes of films and cover even wider latitudes.

6.4.17.2.2.2 Technique Parameters. Several parameters must be considered when choosing a multiple film technique. In addition to the exposure parameters always of concern in radiographic inspection, the radiographer must be concerned with the choice of film to be used and the combination of these films with various screens.

6.4.17.2.2.2.1 Film Choice. The film combination selected is based on the range of thicknesses that must be covered in a single exposure. The simplest multiple film techniques employ two different films, such as a Class 1 and a Class 2 film, to cover the range of densities for the inspection of an object. An exposure must then determine which best provides the combination of contrast and sensitivity in the two films.

6.4.17.2.2.2.2 Film Positioning. When film is double-loaded, realize the film nearest the X-ray source acts as an absorber and the film furthest from the source will receive less exposure. This absorption effect is of considerable magnitude at low kilovoltages and decreases with increased radiation energies. The choice of film position will affect the range of material thickness that can be visualized in a single exposure. Typically, the slowest film is placed nearest to the source, while the faster film would be placed farthest from the source. Pre-packaged double-loaded film will normally be marked “source-side” by the manufacturer to make positioning easier. Once a technique has been established, care SHALL be taken to assure the same film is always placed in the same position for the exposure. If the positions of the films are inadvertently switched, the resulting densities in the final images will be different than expected.

6.4.17.2.2.2.3 Multiple Film Techniques with Lead Screens . Lead screens have a definite effect on the quality of a radiographic image. Lead screens are very dense, and preferentially absorb the lower energy scattered radiation. This reduces the fog on the final image and allows a higher contrast, higher quality image. Also, at energies above 125 kV, lead screens provide a definite intensification. This intensification is due to the efficient conversion of X-ray photons into electrons in lead foils. These electrons in turn expose the X-ray film and thus provide intensification in the final image. These properties of lead screens MAY be useful in developing a multiple film technique.

6.4.17.2.2.2.3.1 As discussed earlier, combinations of films can be used for radiography of multi-thickness materials, but the optimum image quality MAY NOT be achieved. Therefore, the use of lead screens MAY be introduced to help regulate the relative speeds of the films used. As an example, assume the combination of a Class 1 and a Class 2 film could not provide the required latitude for a given component. Lead screens can be used to increase the latitude of the total exposure.

6.4.17.2.2.2.3.2 Most lead screens consist of thin lead foils backed on one side by cardboard, rubber, or vinyl. With this configuration, lead screens have a filtration effect on the films beneath them and an intensification effect on films facing the foil-coated side. If a combination of a Class 1 and a Class 2 film is used and insufficient latitude is provided, the latitude MAY be increased by placing the faster Class 2 film nearest the source with a backed 0.005-inch lead screen between the two films with the lead screen in contact with the Class 2 film. This increases the latitude through two effects. First, the lead foil intensifies the near Class 2 film, and second, the lead acts as a filter, slowing the response of the Class 1 film. Thus, over all the latitude of the exposure is increased.

6.4.17.2.2.2.3.3 On the other hand, if the latitude was excessive with the two films using no screens, the opposite effect can be achieved by placing the slower film nearest the source and the faster film farthest the source, with lead screens in between facing the slower film. This combination speeds up the slower film by intensification and slows down the faster film by filtration. Thus, the total latitude is reduced.

6.4.17.2.2.2.3.4 When only a slight increase in latitude is required, two sheets of the same film class may be employed, and lead screens MAY be used as described above to achieve a relative speed difference between the two films.

6.4.17.2.2.2.3.5 There is no end to the combinations that may be employed in multiple film radiography. Using the principles outlined above, any capable radiographer SHOULD be able to accommodate a wide variety of complex components with a multiple film exposure. Experience provides the required proficiency.

6.4.17.2.3 Triangulation Technique. In some cases, it is desirable to know the location of a given discontinuity relative to one of the plane surfaces of the object. If repairs are to be made, it is desirable to know from which surface the repair SHOULD be started. A single radiograph MAY NOT reveal this information. This information can be obtained by making a double exposure with suitable markers placed on the object. These markers are placed on both the source side and on the film side. Either two exposures can be made on one film where discontinuity is very prominent; or two separate films can be used and later be superimposed. These radiographs can be used for measurement purposes to obtain the desired information ([Figure 6-44](#)).

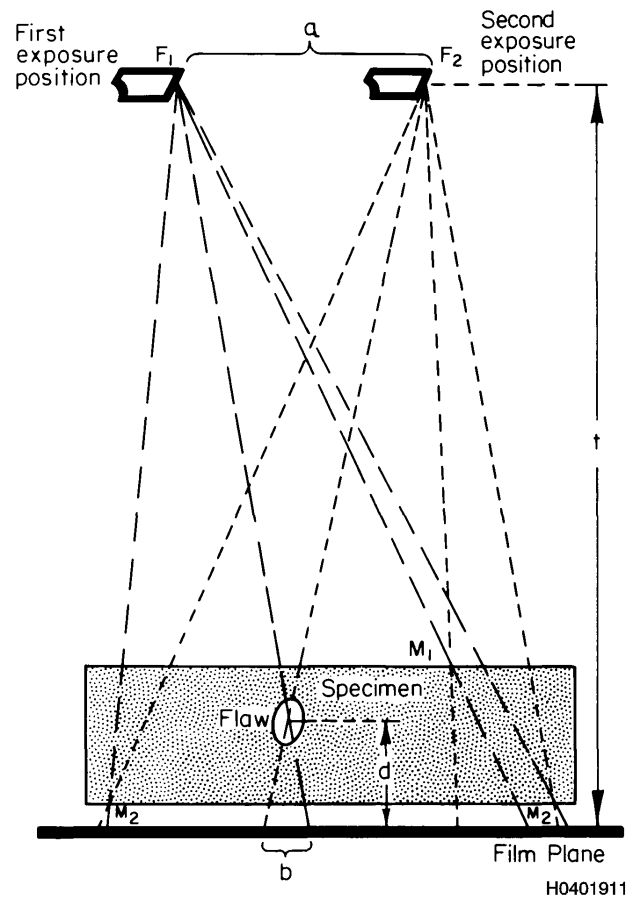


Figure 6-44. Triangulation Technique Used to Determine Flaw Depth in an Object

6.4.17.2.3.1 In this technique, small lead markers, usually in the form of triangles, are attached to the two surfaces of the object, one set of three or four markers on the source side and one set on the film side. If two separate exposures are to be made, each film SHALL be carefully aligned with the object so both films occupy the same position. After the markers are positioned, one exposure is made with the normal source, object, and film position. A second exposure is made with all conditions the same between the object and film with the exception that the source is shifted 10° to 45° from the initial position. The greater this shift, the greater the accuracy of determining the position of a given discontinuity from one of the object's surfaces.

6.4.17.2.3.2 If the discontinuity is sufficiently prominent, both exposures MAY be made on the same film. In either case, the distance of the discontinuity above the film is given by the following expression:

$$d = \frac{bt}{a + b}$$

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Where:

d = distance of discontinuity above film plane

a = distance of the source shift

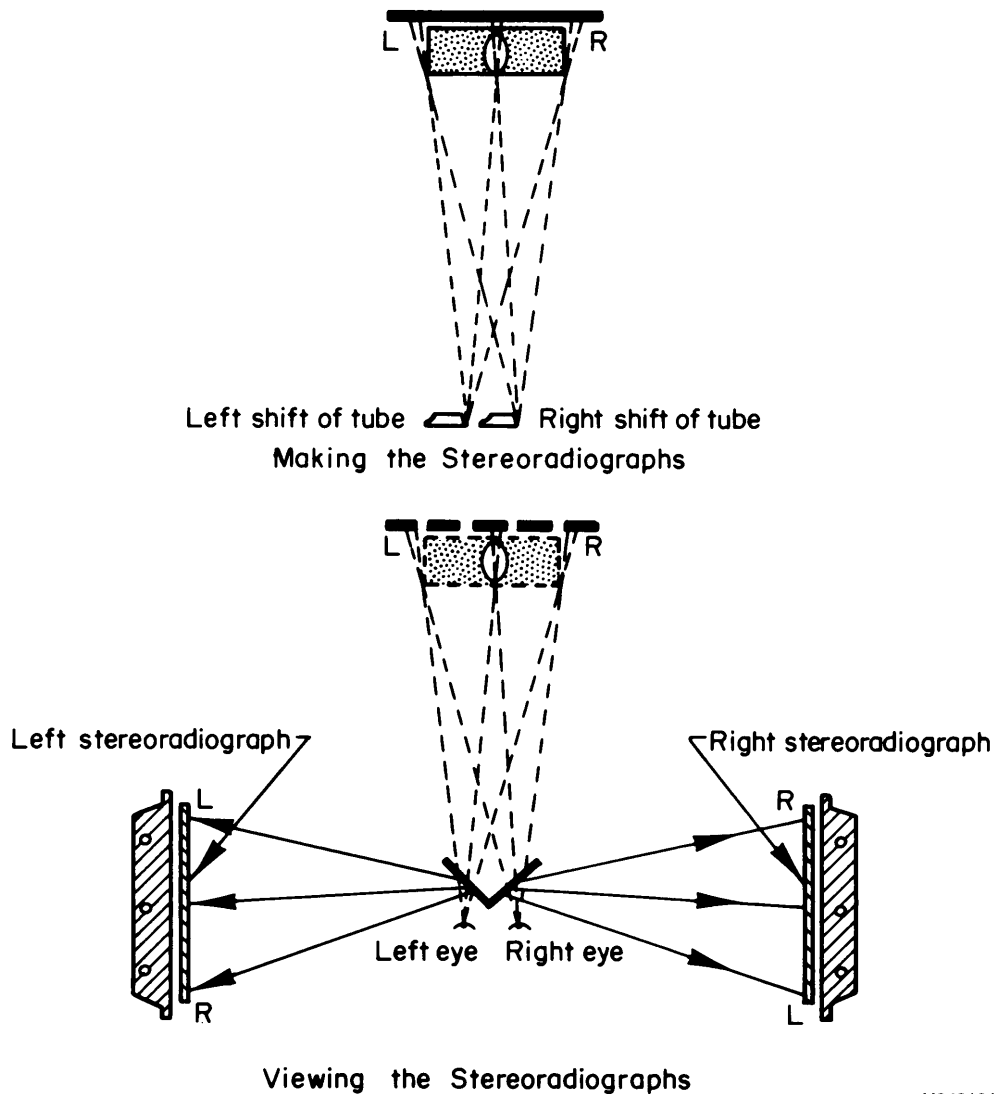
b = change in position of discontinuity image on radiographs

t = source film distance

6.4.17.2.3.3 It is good to know which of the two surfaces of the object is nearest to the discontinuity. In this case, the shift of the discontinuity and marker images is measured. If the shift of the discontinuity image is less than one-half the shift of the markers on the source side of the object, then the discontinuity is nearer to the film. If the shift is greater than one-half, the discontinuity is nearer the markers on the source side of the object.

6.4.17.2.4 Thickness Measurement. Sometimes it is impossible to determine the thickness of an object using conventional mechanical measurement techniques. In these instances, a special radiographic technique for the measurement of material thickness MAY be employed. Although the mathematical development of a relationship between film density and the thickness of an absorber is too complex for practical use, an empirical method of thickness measurement has proven useful. By exposing the object of interest and a step wedge of the same material on a single film, it is possible to obtain a good estimate of the thickness of the material section. It is imperative the composition and structure of the step wedge be the same as the material being measured if any accuracy is to be achieved. Thickness is determined by measuring the resultant film density and finding the step on the wedge is that nearest to the same density. For best results, the section of interest and the step wedge SHOULD be placed as close to one another as possible to avoid variations in the uniformity of the radiation beam. This technique MAY also be employed to measure void dimensions (parallel to the beam direction).

6.4.17.2.5 Stereo (Three Dimensional). Normally, objects appear in their true perspective and correct spatial relationship because of a property of the eyes, called stereoscopic vision. That is, each eye receives a slightly different view and the two images are combined by interpretation to give the impression of three-dimensions. A single radiographic image does not possess this perspective; therefore it does not give the impression of depth. However, some estimate of depth can be judged from detail observed by an experienced radiographer. The mechanics of stereoradiography are relatively simple. Two radiographs are made from two positions of the X-ray tube. These positions can be thought of as the “left eye” and the “right eye.” As a matter of fact, the two positions represent the distance between the eyes. A so-called stereoscope is used to view the images ([Figure 6-45](#)). Each eye sees only one image but the brain blends these two images into one.



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Figure 6-45. Sketch Showing Procedure for Making and Viewing Stereo Radiographs

6.4.17.2.5.1 Remember the radiographic image produced does not define the surfaces of the object as in a photo or by direct vision. This is because no radiation is reflected from the surface as under normal optical means. Therefore, in order to obtain apparent depth, it is usually necessary to define the surfaces of an industrial object by means of an X-ray attenuating marker such as a very coarse, high-absorption mesh or grid. These grids can be easily constructed by using 1/16-inch solid lead solder. Such grids, especially on objects with plane surfaces, SHOULD be placed on both the source and the film side.

6.4.17.2.5.2 It is important when taking the radiographs for the distance of shift of the source to be approximately one-tenth the focal film distance. Also, in viewing the resultant radiographs, each film must be positioned so as to duplicate the exact conditions of exposure. That is, the eyes of the viewer SHOULD be in the same relative position as the focal spot of the X-ray tube or source. This positioning is facilitated by placing a different lead marker on each of the two films. The eyes will then see a true representation of the part just as the X-ray tube saw the actual part.

6.4.17.2.5.3 Stereoradioscopic methods can also be used to present stereo images when using realtime radiography.

6.4.17.2.6 Geometric Magnification. For some applications, it is desirable to magnify the radiographic image. This can be done optically after the radiograph has been taken, or it can be done during the radiographic process by using geometric

magnification. This is particularly effective when X-ray sources with small focal spots are used (e.g., the mini-focus and micro-focus sources) as described in [Paragraph 6.3.3.2.3](#). Geometric enlargement can be realized by moving the radiographic object away from the detector, toward the radiation source. Moving their inspection object halfway between the X-ray source and detector produces a magnification factor of two. If the object is closer to the X-ray source (say 1/10th of the source-detector distance) then the magnification is ten times. Useful radiographic images have been produced with small micro-focus sources with geometric magnifications of 10X or more. Although this discussion has covered geometric magnification using only a film detector, this special method can be used with any imaging detector, including radiosopic detectors. Recognize as magnification increases the inspected volume of the object decreases. Therefore, more radiographic views MAY be needed for a complete inspection.

6.4.17.3 Special Imaging Methods. Conventional film radiography has its own capabilities and its own limitations. The capabilities of film radiography have been covered thoroughly in the previous sections. Consider some of the limitations of film radiography. Film takes a long time to process, and the results of the inspection cannot be known until the film is processed. Therefore, in some situations, a need exists to provide a more rapid means of imaging. There are many alternatives to the use of conventional film for recording radiographic images. These include the use of “radioscopy,” “image intensifiers,” “X-ray vidicon,” “stereo radioscopy,” “photo-radiography,” “Polaroid radiography,” “photothermographic film,” “computed tomography,” “neutron radiography,” and computed “digital” radiography. The following paragraphs discuss the advantages and capabilities of these imaging systems. Most provide for more rapid imaging than is available using conventional film radiography. However, each of these methods also has its own limitations. Special imaging methods not included in authorized inspection manuals SHALL NOT be used without written approval of the appropriate depot engineering authority.

6.4.17.3.1 Radioscopy. The oldest non-film imaging method involves the use of fluorescent screens to produce a visible image. These phosphor screens fluoresce (emit visible light) in proportion to the amount of radiation striking them. Thus, an instantaneous visible image is produced, and the results may be instantly read using a now outdated method called fluoroscopy. Modern, prompt-view, or real-time radiosopic systems make use of closed-circuit television systems to bring these images out to a safe viewing location, where a bright television image can be viewed. Radioscopy is defined in ASTM standards as “the electronic production of a radiological image that follows very closely the changes with time of the object being imaged.”

6.4.17.3.2 Fluorescent Screens. The light-emitting fluorescent screen can be viewed directly to see the prompt X-ray image. However, this method is rarely used now because closed-circuit television methods can provide a safer, more efficient environment to view the low-light level signal from the fluorescent screen. The fluorescent screen light signal can be detected by sensitive television cameras, such as the image orthicon. In some systems, the weak light signal from the fluorescent screen is amplified by using a light-image intensifier tube between the fluorescent screen and the television camera.

6.4.17.3.3 Image Intensifiers. Image intensifiers are specially designed, evacuated electronic tubes, which intensify the image on fluorescent screens with very fine grains. The input signal, fine grain screens used in image intensifiers, do not produce sufficient light to be viewed and employed for direct fluoroscopy. Therefore, an image intensification system is employed as shown in [Figure 6-46](#). The fluorescent screen is backed by a photo-emissive layer that produces electrons in proportion to the number of visible light photons emitted by the fluorescent screen. A series of focusing and accelerating electrodes propel these electrons toward a second and much smaller fluorescent screen, which has very high detail resolution. This screen is typically viewed by a light-sensitive vidicon or other television camera and displayed on a television monitor. The image intensifier provides the immediate imaging capability of the fluorescent screen while providing higher brightness and detail resolution in a safe area remote from the radiation. However, resolution is still less than obtained with Class 4 radiographic films. There is also no permanent record provided unless a photograph or video tape is made. The X-ray image intensifier is widely used as part of a radiosopic X-ray inspection system.

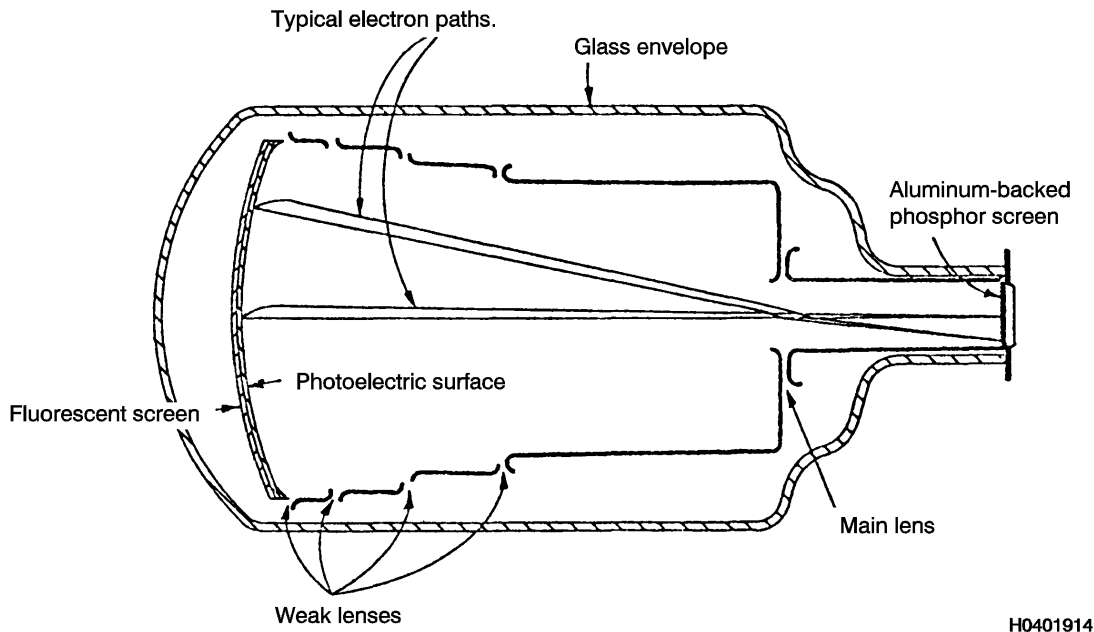


Figure 6-46. Typical Image Intensifier Tube

6.4.17.3.4 X-ray Vidicon. The X-ray vidicon system consists of a specially designed television camera directly sensitive to X-rays. It has a specially coated face capable of imaging X-radiation, because its electrical resistance changes with radiation, a phenomenon called photoconductivity. This small area coating provides very fine resolution. The results of this type of inspection are displayed on a television monitor. The sensitive area of the television vidicon tube is generally very small, on the order of 3/8 by 1/2-inch. When this small area is viewed on a 17-inch television monitor, a magnification of 30 times results, thus, very high detail resolution is accomplished. These systems are used primarily for the inspection of very fine detail, such as in the inspection of microelectronic circuits. This system is capable of resolving wires as small as 0.001 inch in diameter.

6.4.17.3.5 Stereoradioscopy. Stereo imaging can be done in real-time, using microfocus X-ray sources, geometric magnification, and radioscopy systems. The stereo pair images can be obtained using only minimal movement of the microfocus X-ray source when geometric magnification is used. This stereo pair imaging can be done by magnetic movement of the X-ray tube electron beam. The two stereo views, obtained at TV field rates (1/60 second), can be combined electronically into a stereo pair image for 30-frames/second viewing. An observer, wearing special polarizing glass and looking at the television stereo image through a 1/60 second changing polarizing filter, will see a stereo, radioscopy image.

6.4.17.3.6 Photoradiography. Photo radiography is a combination of radioscopy and photography. In this method, the image of a fluoroscopic or image intensifier output screen is photographed by a conventional camera on small or miniature-type film rather than by direct contact. This method has the advantage over fluoroscopy in the film has the property to integrate and react to the total light emitted by the screen during the time of exposure, whereas the integration time of the eye is relatively short. Furthermore, the resultant film can be viewed with transmitted light and the photographic process can be used to enhance the contrast of the fluorescent image. This method has been used to limited extent for the examination of propellant grains, die and precision castings, and similar parts and assemblies when a large number of parts of the same configuration and size are inspected. Airframes have been inspected for component shift and material changes by using photoradiography. The system has limitations since all fluorescent screens commonly used are grainy. In addition, there is loss of definition through the lens of the camera. The main advantage of the system is that it is less expensive because of the use of smaller sized film. The image can be enlarged for viewing by a magnifying system or by projection. In general, this system permits radiographic sensitivity of about four to five-percent. The photoradiography accessory is available as an assembly and usually consists of a light-tight hood, a fluorescent screen or image intensifier assembly, and the camera. Various type cameras are available, some, of which employ sheet film and others using 70-mm roll film.

6.4.17.3.7 Polaroid Radiograph. If a convenient, permanent image is needed and the time required for conventional film radiography is prohibitive, an alternate MAY be radiography with other film. An example of this is Polaroid radiography. Just as Polaroid photography facilitates very rapid development of photographic images, there are available Polaroid X-ray films which provide the same advantages. These require the special Polaroid film holders and a film processor if the larger sizes are used. In some cases the typical Polaroid 4 by 5-inch adapter can be used. Polaroid radiographic films are used just as regular films are used in conventional film radiography. They have their own characteristic curves and an appropriate exposure technique SHOULD be used. However, after the exposure has been made, rather than process the films by conventional techniques, they are dry developed as a Polaroid photograph, and results are available after about one minute. Currently, available Polaroid films provide for either viewing by reflected or transmitted light. Polaroid radiographs provide nearly instant interpretation and a permanent image. However, Polaroid radiographs are low in contrast and detail resolution compared to conventional film. Polaroid radiographs can be made to establish the geometrical alignment of the X-ray beam with the part before a typical film radiograph is exposed. This technique is useful in those cases where critical alignment is required.

6.4.17.3.8 Photothermographic Film. The photothermographic process uses a special “dry silver” film which is heat processed, eliminating the need for chemical processing. The film is sensitive to visible green light. Therefore, to produce the image, phosphor intensifying screens are placed in intimate contact with the film. When struck by X-rays, the screens fluoresce, forming an image on the film. Because film itself is insensitive to X-rays, care SHALL be taken to assure the coated side of the film is in direct contact with the coated side of the screen during the exposure. Since this film is dependent upon the screens for forming the latent image, only screens approved by the film’s manufacturer SHALL be used. To aid in maintaining the necessary contact, vacuum cassettes SHALL be used for holding the film and screens, unless an approved procedure states otherwise. Photothermographic film is less sensitive than Class 4 films; therefore, it is not suitable for most critical applications and SHALL NOT be used for critical crack detection. Photothermographic film is processed by exposing the film to heat in a special thermal processor. The heat causes the latent image in the silver halide grains to form in the reducible silver salts. This process is very fast; typically requiring 20-seconds to process a 14 by 17-inch film. During this process the radiograph is also stabilized, requiring no additional processing. The image produced SHOULD remain stable for years under normal storage conditions. However, exposure of the film to bright light for several days could cause some discoloration of the white background.

6.4.17.3.9 Computed Tomography (CT). Computed Tomography (CT) is a radiation inspection method that can provide quantitative density and geometric images of thin cross sections of an inspection object. The method, adapted for nondestructive testing after extensive use in medical radiology, employs a computer to reconstruct an image of a cross-sectional plane through the object. CT inspection of a tree, for example, would look very much like the surface of a tree stump, showing the varying density of the winter and summer wood rings and an accurate representation of the tree growth rings. CT information is derived from a large number of observations of radiation intensity over many different viewing angles. Using CT, one can, in effect, slice open the test object, examine its internal features, perform dimensional inspections and identify any material or structural anomalies that may exist. As compared to conventional radiography, a major advantage of CT inspection is internal structures are not hidden or shadowed by other structures that might be in the beam path. Also CT inspection can provide quantitative information about density variations and spatial locations within the inspected material. An obvious disadvantage is that currently used CT image reconstruction methods require full access to the inspected part; full 180-degrees of data must be collected by the scanner. Also, the inspection object must be small enough to fit in the CT handling and scanning system. Systems large enough to handle missiles up to 9-feet in diameter are in use.

6.4.17.3.10 Neutron Radiography.

6.4.17.3.10.1 Description. Neutrons are useful for radiography because the attenuation of thermal neutrons is very different from that of X-rays. In general terms, the attenuation pattern is reversed, as many light materials (e.g., hydrogen, lithium, boron) have high attenuation of thermal neutrons while many heavy materials (e.g., bismuth, lead) are relatively transparent. Therefore, in this sense, neutron radiography can serve as a complementary inspection technique to X radiography. The advantages of thermal neutron radiography include excellent sensitivity to materials containing low atomic number elements (particularly hydrogen, lithium, and boron), some additional high attenuation materials (examples include silver, cadmium, indium, and gold), and rare earth elements (particularly samarium, gadolinium, and dysprosium).

6.4.17.3.10.2 Applications. Sensitivity to low atomic number materials opens up neutron inspection to a variety of applications involving water, explosives, fluids, rubber, plastics, and corrosion products (usually a hydroxide). An example of this type of inspection is neutron radiography of small explosive devices in metal cases to assure the presence of the explosives. Lead-covered explosive lines represent such an example. Inspection applications involving materials like cadmium have been demonstrated in the nuclear industry for cadmium reactor control materials. Cadmium plating inspection can also be

considered. A major application involving rare earth materials is the inspection of investment-cast turbine blades to detect residual ceramic core left in cooling passages after leaching.

6.4.17.3.10.3 Disadvantages. Disadvantages of neutron radiography include the relatively high cost and additional radiation safety problems. Where high volume applications exist, for example turbine blade inspection, cost need not be a prohibitive factor. The additional radiation safety issues arise mainly from the generation of radioactivity in the inspection sample. These problems are rare and where they exist they are usually easily handled by shielding and/or short waiting-time periods for the radioactivity in the sample to decay.

SECTION V INTERPRETATION OF RADIOGRAPHIC INSPECTION

6.5 RADIOGRAPHIC INTERPRETATION.

6.5.1 General. The recording of an X-ray image pattern on a film is called radiography. This film, when processed, is called a radiograph. Its interpretation is called radiographic inspection. To obtain the greatest value from this procedure, characteristics of the radiograph must be understood and properly applied. It is possible to make erroneous deductions based on radiography that could result in improper disposition of the material. It is the duty of the radiographer to continually guard against this possibility. The interpretation and correlation of this information is affected by a number of characteristics in the process that ultimately are reflected in the radiograph. The characteristics of the radiograph are reviewed and discussed in the following paragraphs.

6.5.2 Radiographic Image Quality. Radiographic interpretation cannot be performed without knowledge of the image quality. Knowledge of the image quality tells the film reader the minimum size of discontinuities they can expect to visualize.

6.5.3 Sensitivity. Radiographic sensitivity is defined as the differential in thickness, in terms of percentage of total thickness recorded by radiography. This sensitivity is a result of X-ray image contrast, film contrast, image sharpness, image distortion, and image density obtained in the radiograph. In normal radiographic practice no attempt is made to record the ultimate radiographic sensitivity in each radiograph. However, it is required that a certain quality of radiography be attained to assure satisfactory inspection. To assure this quality of inspection by radiography, image quality indicators are used. The application of IQIs is discussed in an earlier section.

6.5.3.1 Examination of the IQI image on the radiograph will indicate the sensitivity. Correct radiographic procedure will show the image details of the IQI sharply defined. However, the IQI sensitivity is a gauge of a certain standard of sensitivity. It cannot actually measure the sensitivity in percent. This idea of IQI sensitivity has several limitations that SHOULD be kept in mind:

- The eye is limited in resolution.
- Discontinuities are detectable only in the direction of primary radiation.
- Variations in material density are not considered.
- Definition or sharpness of transition between densities is not considered.
- Actual defects are usually irregular in shape while IQI have a definite size and shape.

6.5.4 Definition or Detail. Definition or detail in radiography is the sharpness of the image outline reproduced on the film. The size of the focal spot, the physical condition of exposure, and the film resolution determine the definition. If a screen is used, then the screen resolution will also affect the definition. In addition to the focal spot size, the object-to-film distance is an important factor in the sharpness of shadow picture ([Figure 6-47](#)). The resolution of the film is a function of grain size.

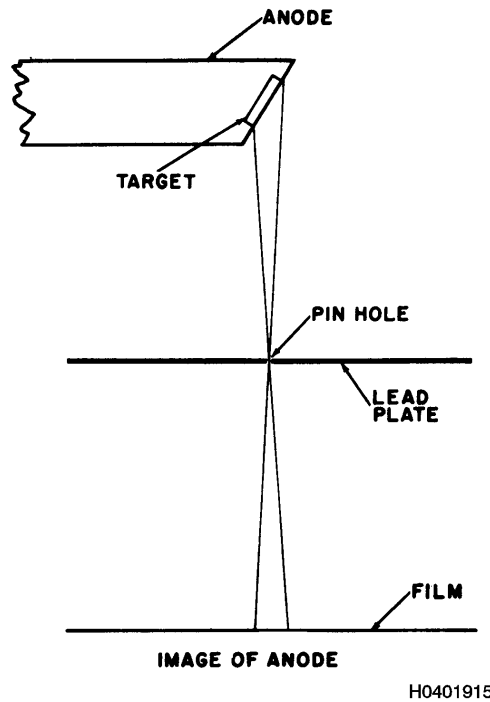
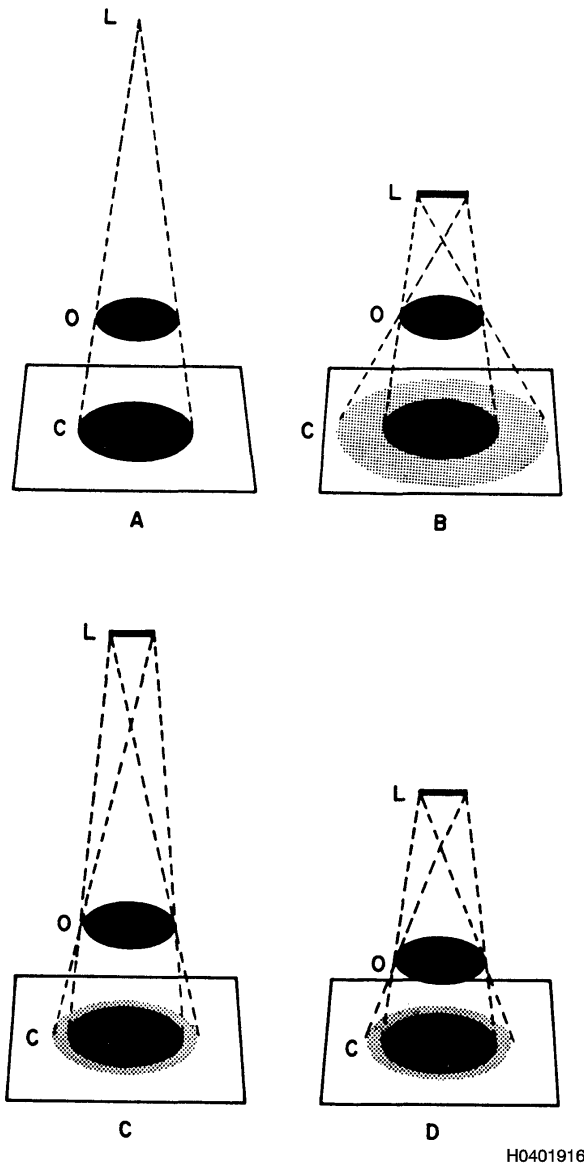


Figure 6-47. Pinhole Picture of Focal Spot

6.5.4.1 Since the radiograph is a shadow picture, the geometric interrelationship between the elements of the radiographic system is important. Ideal X-ray focal spots and radioisotope sources SHOULD be pinpoints. With such sources, we would obtain sharp images under all conditions. All our radiation sources have finite size since X-ray tube focal spots must be large enough to withstand the energy dissipated as heat to prevent melting and target destruction. The radioactive activity of an isotope is proportional to the source strength in curies, so the smaller the size, the lower the intensity.

6.5.4.1.1 To better understand geometrical relationship, [Figure 6-48](#) illustrates various conditions true to X-ray and light shadow formations. Diagram "A" in [Figure 6-48](#) shows the size of the shadow is to the size of the object as the distance of the light to the card is to the distance of the light to object. This image is a true projection. If the source has finite size, the shadows cast will not be perfect projections, but will have surrounding areas out of register, producing a gray cast of unsharpness, which is called penumbra. Diagrams "B" through "D" in [Figure 6-48](#) show the effect of changing source size, altering the relative position of source, object, and recording surface. From these examples, it will be seen that the following conditions are desirable to produce sharp shadow images:

- The X-ray source SHOULD be as small as possible.
- The X-ray source SHOULD be as far from the object as possible.
- The recording surface SHOULD be as close to the object as possible.



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Figure 6-48. Geometrical Factors

6.5.4.1.2 There are other factors affecting detail. They include motion, screens, film, and scatter. If the source, object, or film move independently of each other or are not in phase, blurring will result. Rigid supports for all three elements must be used to prevent this blurring. Since characteristics and conditions of film, screens, and scatter are also related to film contrast and density, they will be discussed later in subsequent paragraphs.

6.5.5 **Density.** Radiographic density is the blackening or darkening produced on the radiograph resulting from the metallic silver deposits remaining on the film after exposure and processing. Density is measured in terms of visible light transmission. The accepted scale of density measurement is the logarithm of the ratio of incident light to transmitted light as given by the following equation: ([Paragraph 6.7.6](#))

$$D = \log \frac{I_0}{I_t}$$

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Where:

D = density

I₀ = intensity of incident light

I_t = intensity of transmitted light

6.5.5.1 Measurement of radiographic density SHALL be done with electronic direct-reading type densitometers capable of measuring the light transmitted through a radiograph with a film density up to 4.0 with a density unit resolution of 0.02 ([Paragraph 6.3.11.1](#)). The electronic direct-reading type densitometer is more accurate than the visual type. The densitometer SHALL be calibrated with a reference density strip, traceable to the National Institute of Standards and Technology (NIST), prior to determining the density of a radiograph ([Paragraph 6.3.11.1.1](#)). These calibrated density strips SHALL be replaced whenever they are physically damaged (e.g., scratched, crimped, or become wet by any fluid) to such an extent it might influence their effectiveness. The carbon, dot printed, etc. density strips SHALL NOT be used even though they MAY be NIST traceable. These strips are not able to correlate the densitometer directly to Air Force radiographic needs. Each type of calibrated reference density strip will calibrate the densitometer to a different standard level. The restrictive use of only the photographic or radiographic calibration reference density strip will better enable the standardization of all densitometers to a single calibration value establishing a common (H and D units) density for a given radiographic inspection. The aperture of the densitometer SHALL be black in color. If it is not, it MAY be darkened with a black magic marker or other indelible ink.

6.5.5.1.1 While performing the densitometer calibration procedure, the following SHALL apply:

- a. Follow manufacturer's instructions, substituting the calibration strip supplied with the instrument with the NIST traceable radiographic calibration reference density strip.
- b. The calibration reference density strip SHALL be removed from its protective cover during the calibration procedure, and maintained in its protective cover when not in use.
- c. The calibration reference density strip SHALL NOT be pulled or slid when it is between the aperture and stage diffuser. The aperture SHALL be raised so it is not in contact with the density strip when the strip is being repositioned or removed from the densitometer.
- d. Calibrated reference density strip measurements SHALL be determined from the center of the steps used for the calibration procedure.

6.5.5.1.2 The density of a radiograph is important. Densities less than 0.5 show very little of the object due to three factors: (1) the density of the emulsion base, (2) the basic "fog" of the film, and (3) the lack of uniform response of the film at low radiation exposures. Special illuminators are required to view radiographs with a density of 3 to 4. Radiographs with a density over 4 are extremely difficult to "read." A density of 2 to 3 is recommended for all radiographs.

6.5.6 Contrast. Maximum contrast is achieved in radiography when the maximum X-ray image contrast is coupled with the maximum available film contrast. High-density radiographs viewed with high intensity illuminators provide the best radiographic contrast. As one of the factors that affect sensitivity, contrast SHOULD be high. Some of the general rules regarding contrast are as follows:

- Contrast increases as kV decreases.
- Contrast increases as film development increases.
- Contrast increases as film speed decreases.
- Contrast decreases as kV increases.

- Contrast decreases as film development decreases.
- Contrast decreases as film speed increases.

6.5.7 **Fog.** Fog is the darkening of radiographic emulsion caused by humidity, heat, cosmic radiation, certain chemicals, out of control development chemicals, scatter radiation, and bad development practices. It is defined as the darkening of the film emulsion by an inadvertent cause. The fog level of film brings no useful information to the film and merely creates a high background that reduces contrast and image visibility. The faster the speed of the film, the more susceptible it will be to fogging.

6.5.8 **Distortion and Magnification.** Some of the factors that cause distortion and magnification are discussed in other areas of this manual. However, distortion can also be caused by improper alignment of the X-ray machine and/or film in relation to the object. If distortion is so excessive areas are obscured, it may be necessary to radiograph the object at a different angle. The total distortion or magnification tolerated on a radiograph will depend upon the desired sensitivity and the geometry of the object itself.

6.5.9 **Kilovoltage and Processing.** Any attempt to evaluate a radiograph must take into consideration the conditions under which the radiograph was made. The effects of different kilovoltages and processing techniques cause a variation in contrast and latitude.

6.5.10 **Viewing Radiographs.** Viewing the radiograph is the final step in the radiographic inspection procedure. The radiographer must be aware of the various factors that can influence his decision. Some factors are density of the film, artifacts on films as a result of handling and processing, level of illumination for viewing radiographs, response of human eye to differences in light intensity, and the acuity of vision.

6.5.10.1 **Viewing Conditions.** Reading large numbers of radiographs is a strain on the eyes and fatiguing to the film interpreter. The environment of a film reading area SHOULD be pleasant and SHALL be free of objectionable background light, which MAY cause reflection on the radiographic film. Two and one-half foot-candles of ambient light measured at the viewer is optimum for viewing. This light level will aid the film interpreter by accommodating the eye so they are more sensitive to light. When attempting film interpretation, the radiographer SHOULD wait at least three (3) minutes before reading film, when coming into the viewing room from ordinary artificial room light. When coming from full sunlight, the interpreter SHOULD allow 5-minutes for dark adaptation before viewing. If the eyes are subject to the full brightness of the illuminator during changes of the radiographs, at least 30-seconds re-adaptation is necessary ([Figure 6-49](#)). The film reading illuminator or illuminators SHOULD transmit at least 2-foot-candles of light through the film at the viewing surface of the film. This quantity of light is sufficient to view radiographs with a density of 3-H and D units. There SHOULD also be a high intensity illuminator with a variable light intensity capable of transmitting the required light through densities in the order of 4 to 4.5-H and D units for interpreting these high densities. All film viewers SHALL be of the type that provides a uniform level of illumination over the entire viewing surface.

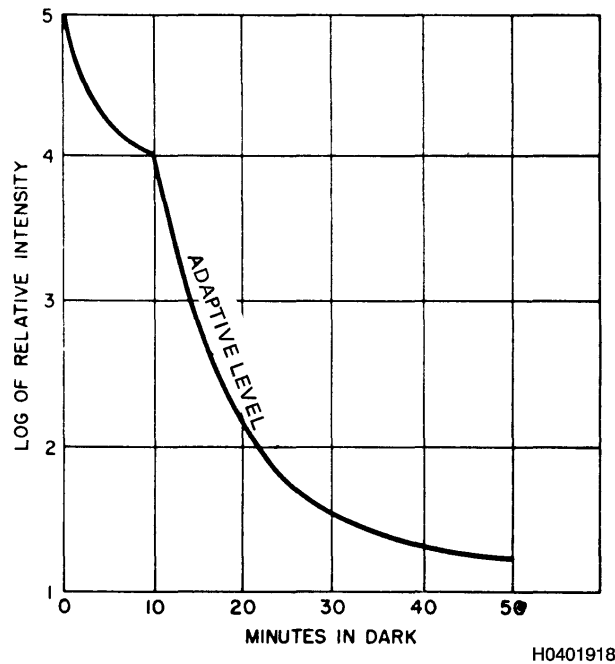


Figure 6-49. Dark Adaptation Diagram

6.5.10.2 Limitations of Eye. The eye is the evaluation medium in radiography. Visual accuracy varies considerably from one individual to another. Oddly enough, a perfect eye does not necessarily mean a perfect visual system. Certain “defects” can be present. Vision must not only record shapes and sizes, but also the variation of light intensities. In this area the eye is especially unreliable. The relative brightness of two light sources, for example, can be gauged only approximately. And even such approximate evaluation is possible only when the light sources are close to the same order of brightness. For example, a bright object or area appears brighter when viewed against a dark field. Conversely, the object will appear darker than it really is when the surrounding area is comparatively brighter.

6.5.10.3 Visual Size. In any task requiring critical examination, we are usually more conscious of size than anything else. The minimum size of an object seen under a given set of conditions is called the threshold size. This varies greatly depending on brightness-contrast between the immediate background and the detail being examined. It also varies with the level of brightness. The physical size of an object can easily be measured, but it is difficult for most individuals to interpret physical size into visual size. The type in which this is printed has a definite physical size measured in points, a point being about 1/72 of an inch. The visual size, however, depends on the distance from the page to the eye. The visual size of the letters at two feet is only one-half that obtained for a page-to-eye distance of one foot. The visual size is the angle subtended at the eye by an object at a distance. The threshold size of a critical detail (such as this black print on a white background) is about one-minute (1/60 of one degree) for persons of normal vision. An individual with sub-normal vision will be able to pick up an object of just about twice the visual size required for normal vision. The relation of a visual size of one-minute of a degree to physical size for different viewing distances is given in [Table 6-20](#).

Table 6-20. Visual Size Versus Physical Size

Viewing Distance (inches)	Physical Size (inches)
10	0.0029
12	0.0035
15	0.0044
20	0.0058
24	0.0070

6.5.10.3.1 For a given viewing distance the visual size is the maximum when the line of sight is perpendicular to the plane in which the object lies. Referring again to this printed page, this means a line from the eye perpendicular to the page. As the page is inclined (to decrease the angle between the line of sight and the page), the visual size of the print is decreased until at 45° the type size is only 70-percent of what it was at 90°. For a 45° angle, assuming an object of fixed physical size and fixed viewing distance, visibility equal to 90° can be had only by increasing the illumination level by 2-1/2 times. An aid in reading radiographic film is the pocket comparator with graduated reticules having linear and circular scales. They are able to measure the size of discontinuities and/or defects depicted on this film.

6.5.10.4 Visual Contrast. A certain level of contrast is desirable between small detail and its immediate surroundings. However, a high degree of contrast between those immediate surroundings and any large area outside the field in which the detail lies is unfavorable. The contrast between this print and the page is favorable, but a high contrast between the page and the desk on which it lies is detrimental to good vision. For each contrast there is a threshold size, and, conversely, for each threshold size there is a minimum contrast if the object is to be just visible. If the eye is to detect a difference as the brightness level decreases, the difference in brightness levels must be greater and greater. It is evident the eye must have considerable time to adjust to low levels of light intensity.

6.5.10.5 Speed of Sight. Sight is not instantaneous, it takes time to see. We do not see when the eyes are in motion. In reading this line, the eyes focus on a point called the point of fixation. This point of fixation is then moved along the line in a series of jumps. The eyes come to a dead stop several times, about three times usually in reading a line of this print. What we do is read a portion of the line during each fixation period. The time of one of the fixation periods varies between 0.07 and 0.3-second. Hence, these times become the limiting periods in seeing. As a visual task increases in difficulty, these fixation periods become longer. Involved, too, is the problem of reaction time, that is, the time that elapses between seeing and acting. Any task involving sight becomes a series of complex time intervals. The time for seeing is naturally greatly influenced by experience, mental reaction time, brightness level, contrast-brightness, and visual size. The rapidity with which any visual examination can be carried out is a relation between these factors and the necessary accuracy or exactness of the examination.

6.5.10.6 Illuminators/Viewers. The illuminator must provide sufficient light to transmit adequate light for the observer to distinguish areas easily. Since the human eye has greater visual acuity and contrast visualization at given levels of light, the illuminator must provide control of light levels to adjust for optimum visual response of observer. The accepted differential of density detectable by the average individual is 0.02. Thus, a 2-percent change in thickness must result in density change of 0.02 or more. The contrast sensitivity of the human eye is greatest when light reaching the eye comes from one source. Therefore radiographs SHOULD be read in areas of subdued light to avoid reflection and glare. The eye responds best if all the light reaching it is approximately the same brightness.

6.5.10.6.1 Opaque masks to suit the size of radiographs being viewed and to isolate areas of interest SHALL be used to avoid brightness around edges of film, excess light from low density areas of no interest and reduce light intensity from the illuminator when changing radiographs. This prevents the eye from continually adjusting itself to the changing light levels that cause fatigue. At normal light levels, the eye can see the differences in light brightness of 2-percent. As light reaching the eye decreases, the percentage increases.

NOTE

Radiographs having great ranges of density and complicated image patterns SHOULD be viewed on high intensity, 14 x 17 illuminators having adjustable diaphragms and variable light intensity to assure best eye response.

6.5.11 Reading (Interpreting) Radiographs. Interpretation of radiographic images cannot be translated into mathematical formulas or routine procedures. The wide variety of test objects and the various fabrication processes by which they have been made makes radiographic interpretation a complex subject. Radiographic inspection is conducted to assure a material or part has the required integrity to reliably perform the function for which it was designed. This does not mean perfection. All parts, materials, and processes are imperfect. Therefore, the purpose of radiography is to determine the degree of imperfection. The effects of discontinuities or manufacturing deviations must be correlated with the function of the part. Specifications are usually used to spell out the discontinuities that could be considered detrimental to the function of the part and the acceptable magnitudes of the discontinuities. It is the duty of the film interpreter to recognize the various discontinuities, their magnitudes, and be capable of relating them to the particular specification required. The responsibility and capability of the radiographic interpreter cannot be over emphasized. Often, many human lives and investments of millions of dollars are depending on the judgment of the radiographic interpreter. Any information that can be of assistance in making a judgment of discontinuities SHOULD be fully utilized. Interpretation of the shadow images visible in the radiograph is an acquired skill, and there is no substitute for experience. Experience aids the film reader in recognizing discontinuities and in identifying where they can be expected to occur in a particular part or structure. The mistakes in radiographic interpretation

most often are a result of misreading film artifacts. There are a number of density patterns that resemble welding and casting defects that are often unjustified causes for rejects. A good check is to look at the surface of the film by reflected light to observe any unusual patterns.

6.5.11.1 The inspector reading the radiographs SHOULD be acquainted with the exposure technique used, material radiographed, conditions of processing, and the geometry of the exposure setup. In this way they can judge more accurately the radiographs produced and interpret the discontinuities more accurately. To determine if the part is rejectable or acceptable they will generally consult with the structural or design engineer unless standards have been established.

6.5.12 Typical Use of Radiography. The radiographic inspection method is expensive when compared to other nondestructive inspection methods, and SHOULD be used for evaluation of internal discontinuities that cannot be evaluated by more economical methods. Therefore surface discontinuities considered detrimental to the function of the part SHOULD be evaluated by visual inspection or other NDI methods more economical than radiography. The major use of radiography is to reveal internal discontinuities. We will now discuss some of the various ways radiography is used to locate discontinuities in castings, welds, and during in-service inspections.

6.5.13 Castings. The process of forming various shapes of metal by pouring molten metals into molds accounts for a considerable share of the critical components of an aircraft. These castings are made by melting ferrous and nonferrous alloys and casting them into useable shapes. The majority of castings encountered requiring X-ray inspections are made of light alloys; that is, aluminum and magnesium alloys. There are a number of inherent difficulties in this manufacturing technique which plague the foundry. Since the molten metal occupies a larger space than the same material after it freezes or cools, precautions SHALL be taken to prevent the metal from shrinking too rapidly and forming voids which are called shrinkage or from rupturing the metal to cause hot cracks. The molten metal also traps considerable gases from the air. These can result in tiny regular shaped bubbles in the solid metal casting. Some metals, such as aluminum, accumulate gas on the surface of the molten metal. This may be trapped in the casting if adequate precautions are not taken to prevent pouring the gas into the mold. In addition, sand can wash from the walls of the mold into the casting forming inclusions that reduce the strength of the castings.

6.5.13.1 It is necessary to control the quality of the casting process to assure reliability of the castings. Radiographic inspection is a satisfactory quality control since the conditions likely to make the casting unacceptable are readily detected by this inspection. For the purpose of inspection, airframe castings can be divided into classes based on their function and on their margins of safety for design loading conditions. These classes are defined in SAE-AMS 2175A "Castings, Classification and Inspection Of" and are basically as follows:

- Class 1. A casting, which the single failure of, would cause significant danger to operating personnel or would result in a significant operational penalty. In the case of missiles, aircraft, and other vehicles, this includes loss of major components, loss of control, unintentional release or inability to release armament stores, or failure of weapon installation components. Class 1 castings SHALL be further classified under Class 1A and Class 1B below.
 - Class 1A. A Class 1 casting, which the single failure of, would result in the loss of a missile, aircraft, or other vehicle. These castings receive 100-percent radiographic inspection.
 - Class 1B. Class 1 casting, which are not included in Class 1A. Radiographic inspection is accomplished in accordance with sampling Table 1 of SAE-AMS 2175A.
- Class 2. All castings not classified, as Class 1. Class 2 castings SHALL be further classified under Class 2A and Class 2B below.
 - Class 2A. Castings have a margin of safety of 200-percent or less. Radiographic inspection is accomplished in accordance with Table 11 of SAE-AMS 2175A.
 - Class 2B. Castings have a margin of safety greater than 200-percent, or for which no stress analysis is required. All target drone castings and aerospace ground support equipment fall in this category, except for such critical parts, the failure of which would make the equipment unsatisfactory and cause the vehicles which they are intended to support, to become inoperable. Radiographic inspection is not required.

6.5.13.1.1 Radiographic examination is ideally suited to the inspection of castings because the most common casting discontinuities are three-dimensional and are, therefore, almost independent of angle of inspection. Exceptions in some cases in-

clude fine cracks, cold shuts, unfused chills, and chaplets. To reveal these, the radiation must be at or near the same parallel plane as the discontinuity. Hairline surface cracks such as those produced by grinding are seldom, if ever, revealed by radiography.

6.5.13.1.2 In most cases, it is possible to identify radiographic images with the common types of discontinuities, which are inherent in the casting process. This information is valuable to the foundry in procedure development work that may be necessary to meet a standard of quality. Although the discontinuities commonly encountered in aluminum and magnesium castings are similar to those in ferrous metals, a group of irregularities called “dispersed defects” may frequently be present. These “defects,” prevalent in light alloy castings, consist of tiny voids scattered throughout part or all of a casting. Gas porosity and shrinkage porosity in aluminum alloys are examples of dispersed defects. On radiographs of sections more than one-half inch thick, it is difficult to distinguish images corresponding to the individual voids. Instead, dispersed defects may appear on film deceptively as mottling, dark streaks, or other irregularities.

6.5.13.1.3 Radiographic studies of new casting produced by the foundry reveal the type and location of internal discontinuities. This aids the foundry to change the casting technique by altering the gating, relocating chills, changing the pouring temperatures, repositioning, increasing or decreasing the risers or altering the size, correcting a faulty sand condition, or increasing the venting in the mold. After developing an acceptable casting procedure the casting can be duplicated with assurance of a quality part.

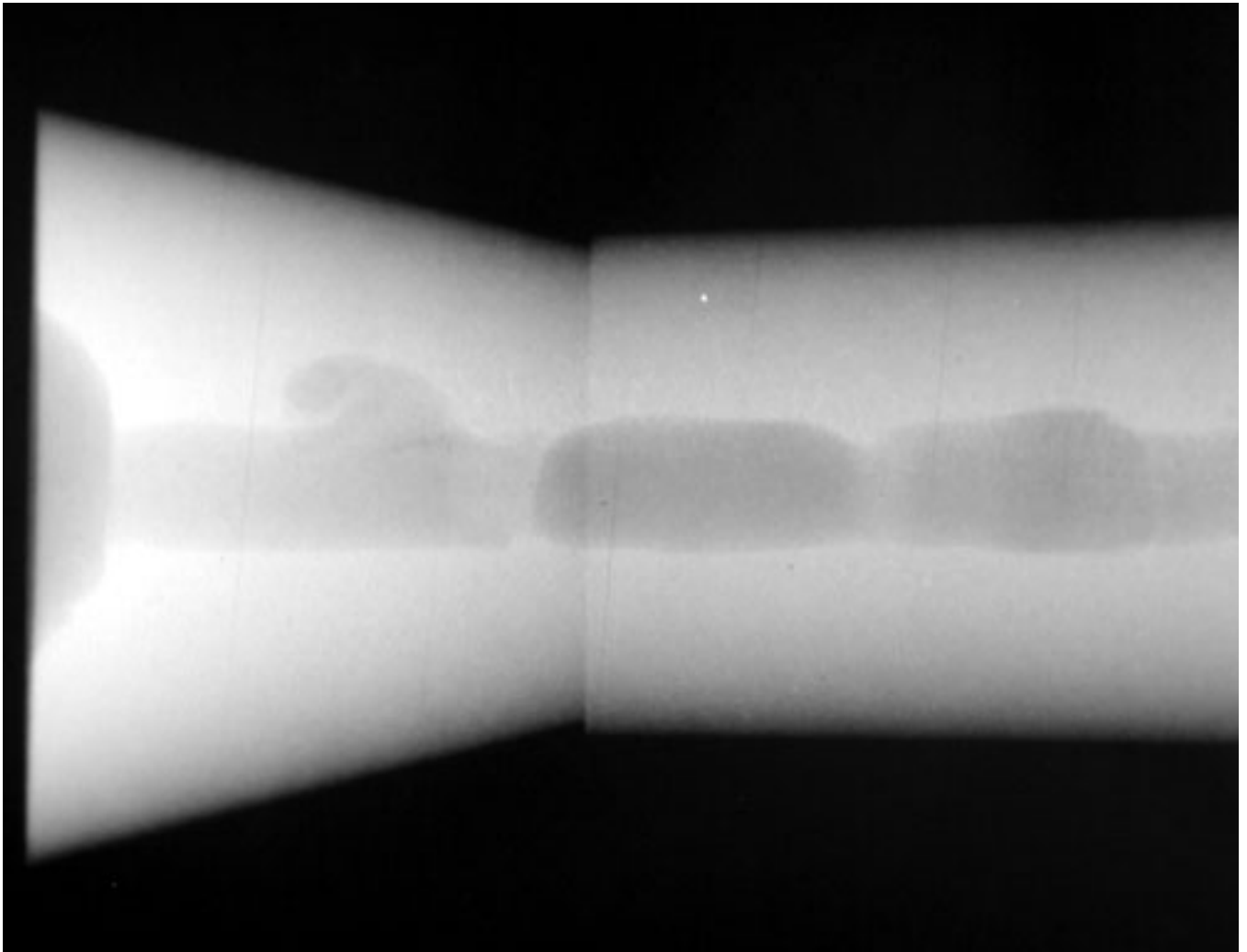
6.5.13.1.4 In general, castings are irregular in shape and can vary considerably in cross section thickness from area to area. Therefore, it is important to utilize equipment of adequate capacity to penetrate the section thickness and kind of material under consideration with a technique giving inherent wide latitude with adequate sensitivity. In some instances, even when radiographing light alloys castings, lead filter screens MAY be employed.

6.5.13.1.5 Correct radiographic procedure requires the selection of the lowest voltage that will do the job in a reasonable exposure time. Where many castings are examined, a convenient technique is to establish a reasonable exposure time and select the voltage required for the thickness of the particular section being radiographed. Good practice normally requires exposures be longer than 1-minute. When castings with great differences in thickness must be radiographed in one exposure, an increase in voltage will provide wider latitude, as well as shorter exposure time; however, contrast is reduced. If other factors remain constant, the most desirable combinations of voltage and exposure time for a specific part being examined may be governed largely by the acceptable radiographic sensitivity.

6.5.14 Casting Defects.

6.5.14.1 Shrinkage. Shrinkage is a form of discontinuity that appears as dark spots on the radiograph. Shrinkage assumes various forms but in all cases it occurs because molten metal shrinks as it solidifies, in all portions of the final casting. Shrinkage is avoided by making sure that the volume of the casting is adequately fed by risers which sacrificially retain the shrinkage. Shrinkage can be recognized in a number of characteristic by varying appearances on radiographs. There are at least four types: (1) cavity; (2) dendritic; (3) filamentary; and (4) sponge types. Some documents designate these types by numbers, without actual names, to avoid possible misunderstanding.

6.5.14.2 Cavity Shrinkage. Cavity shrinkage appears as areas with distinct jagged boundaries see [Figure 6-50](#). It may be produced when metal solidifies between two original streams of melt coming from opposite directions to join a common front; cavity shrinkage usually occurs at a time when the melt has almost reached solidification temperature and there is no source of supplementary liquid to feed possible cavities.

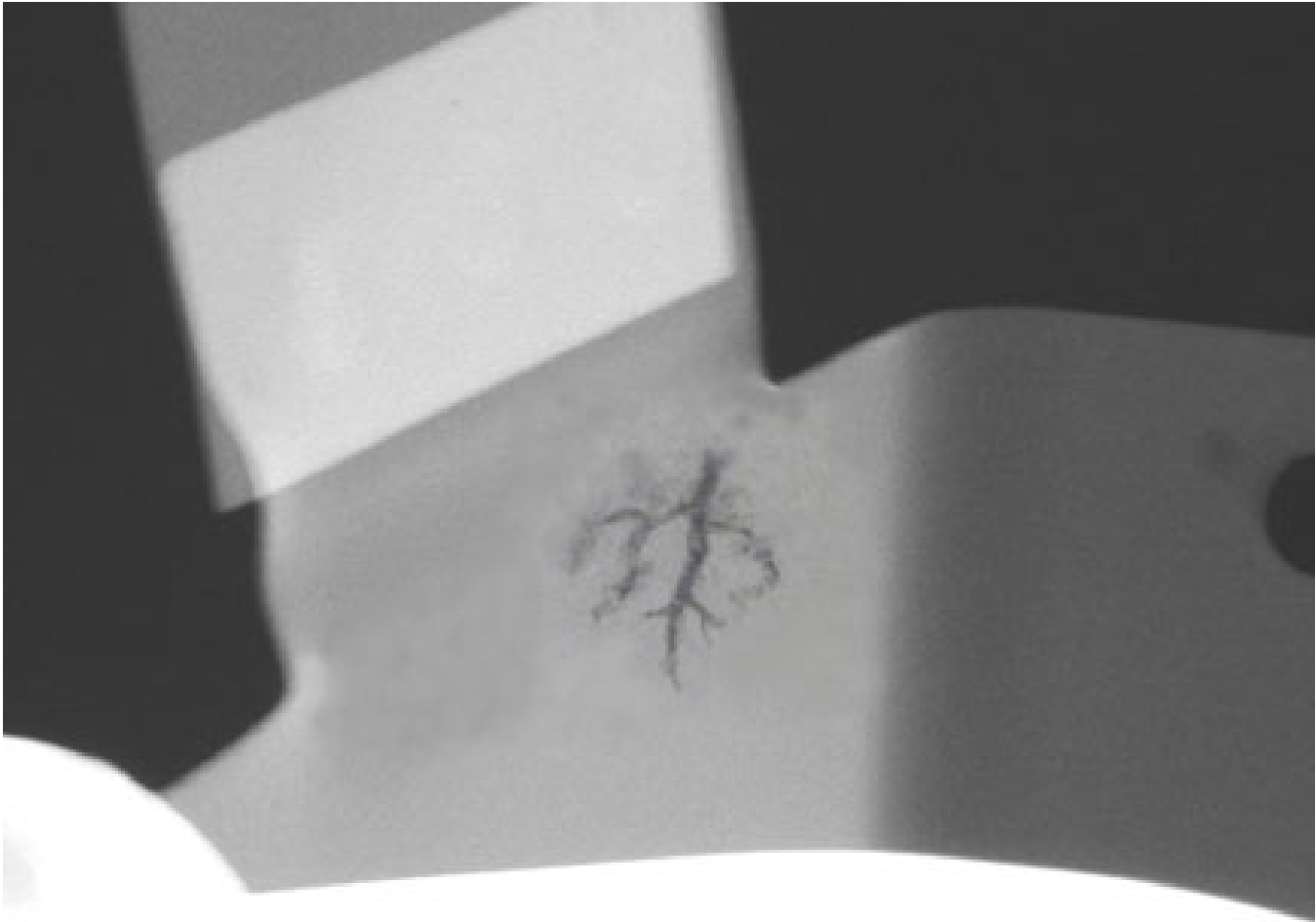


H0703463

Figure 6-50. Cavity Shrinkage

6.5.14.3 Dendritic Shrinkage. Dendritic shrinkage is a distribution of very fine lines or small elongated cavities that may vary in density and are usually unconnected.

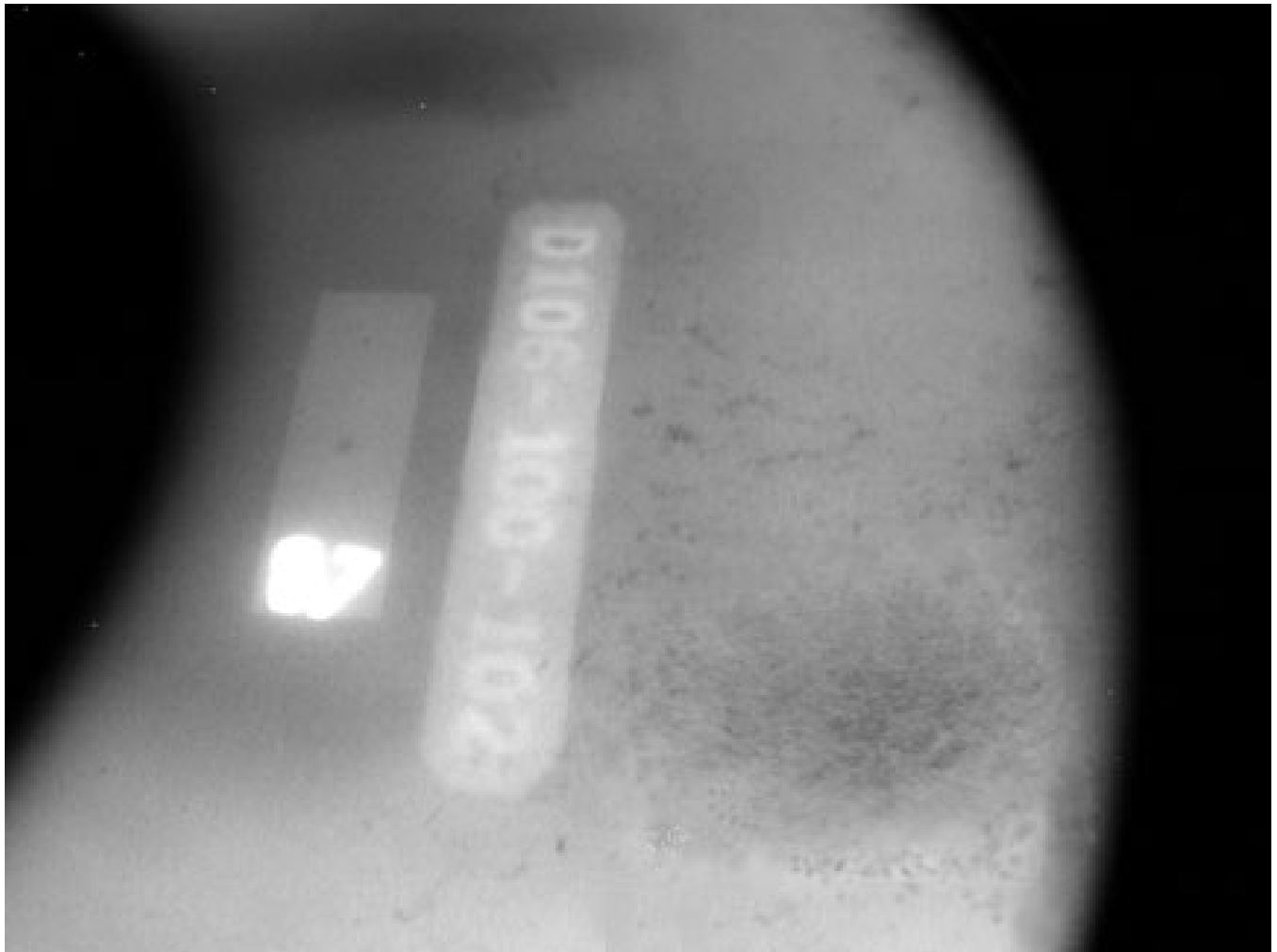
6.5.14.4 Filamentary Shrinkage. Filamentary shrinkage usually occurs as a continuous structure of connected lines or branches of variable length, width and density, or occasionally as a network. Refer to [Figure 6-51](#).



H0703464

Figure 6-51. Filamentary Shrinkage

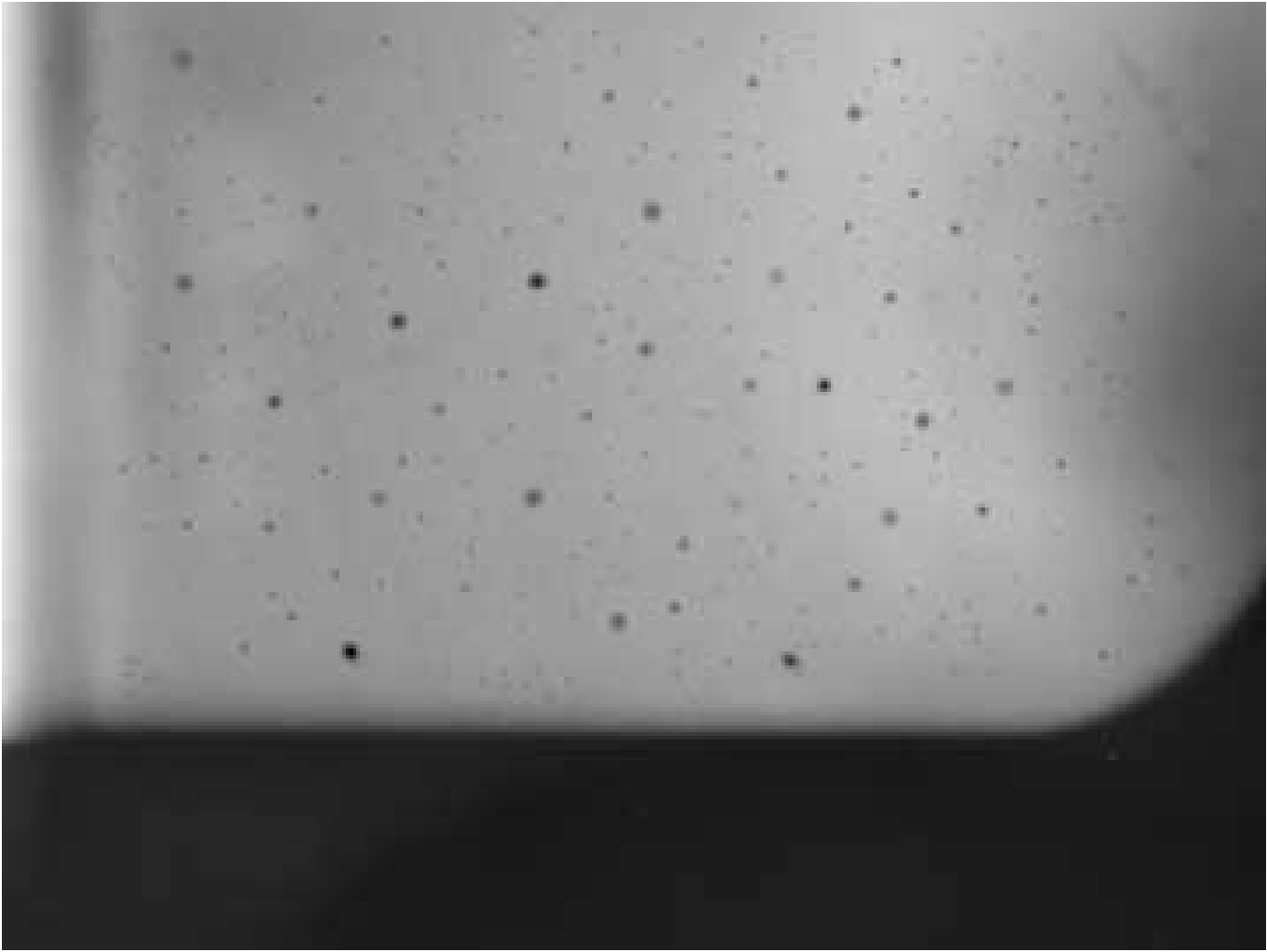
6.5.14.5 Sponge Shrinkage. Sponge shrinkage shows itself as areas of lacy texture with diffuse outlines, generally toward the mid-thickness of heavier casting sections, see [Figure 6-52](#). Sponge shrinkage may be dendritic or filamentary shrinkage; filamentary sponge shrinkage appears more blurred because it is projected through the relatively thick coating between the discontinuities and the film surface.



H0703465

Figure 6-52. Sponge Shrinkage

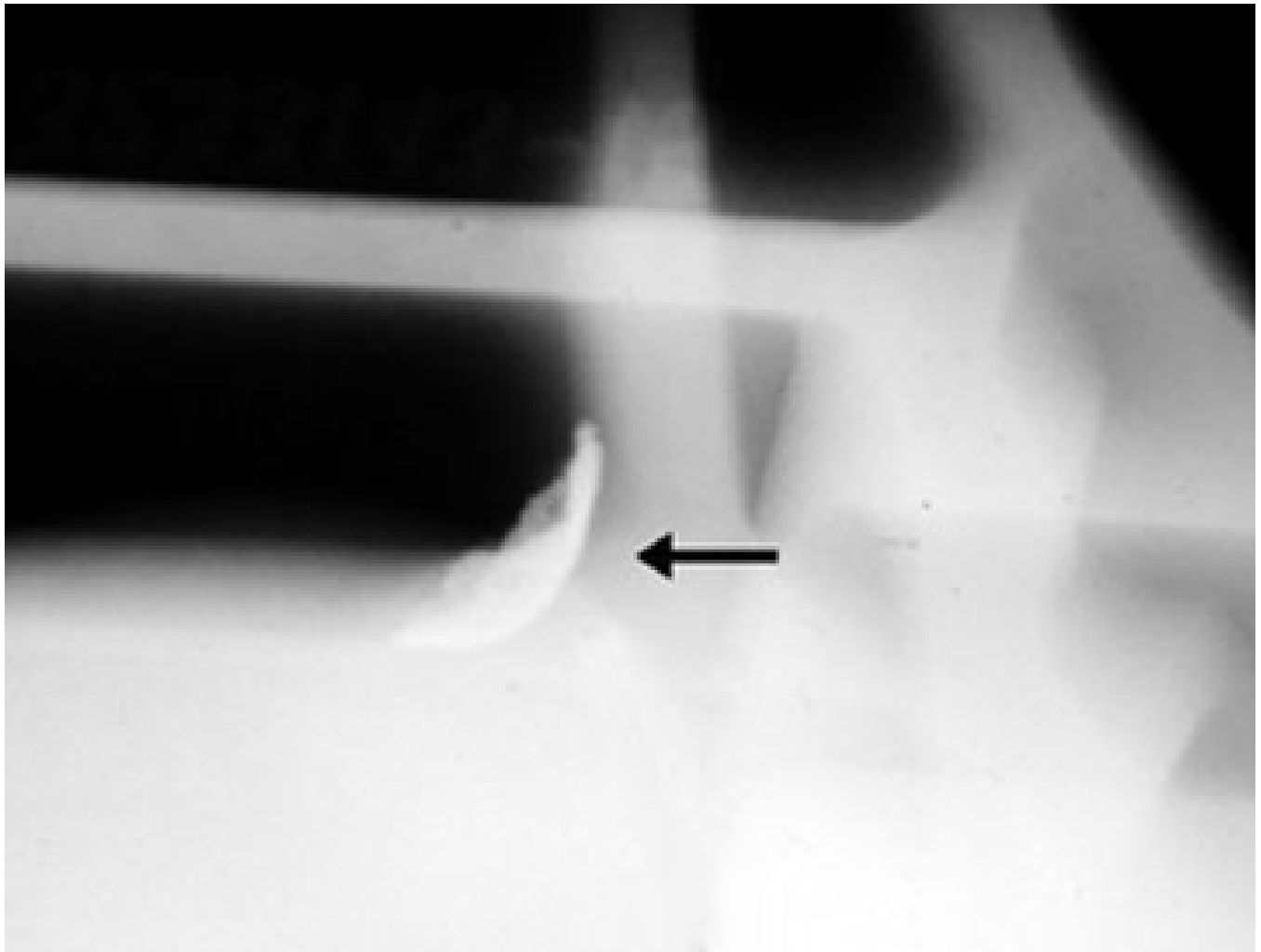
6.5.14.6 Gas Porosity or Blow Holes. Gas porosity or blow holes are caused by accumulated gas or air which is trapped by the metal. These discontinuities are usually smooth-walled rounded cavities of a spherical, elongated or flattened shape. If the sprue is not high enough to provide the necessary heat transfer needed to force the gas or air out of the mold, the gas or air will be trapped as the molten metal begins to solidify. Blows can also be caused by sand that is too fine, too wet, or by sand that has a low permeability so that gas can't escape. Too high a moisture content in the sand makes it difficult to carry the excessive volumes of water vapor away from the casting. Another cause of blows can be attributed to using green ladles, rusty or damp chills and chaplets. Refer to [Figure 6-53](#).



H0703466

Figure 6-53. Gas Porosity

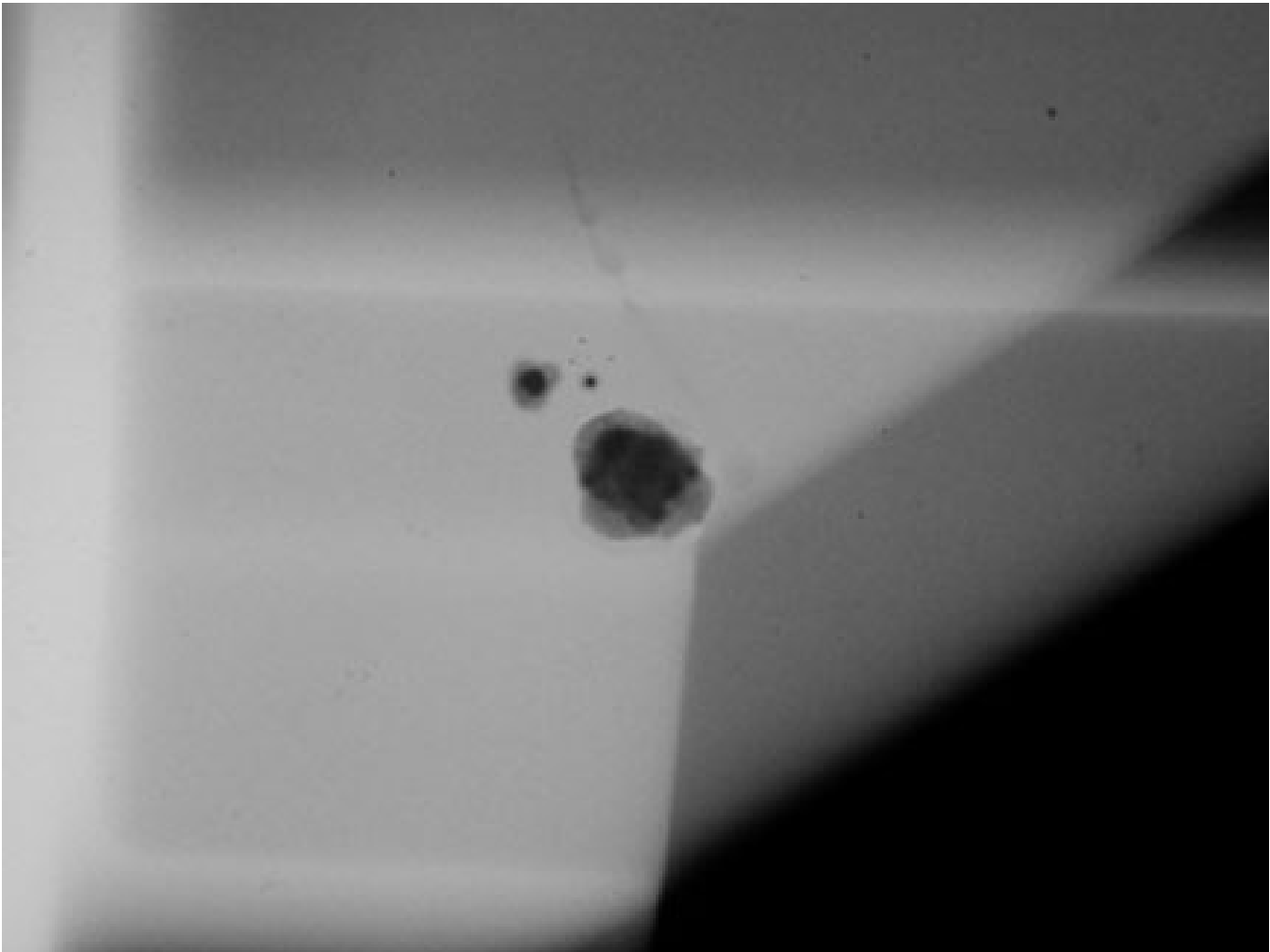
6.5.14.7 Inclusions. Inclusions are nonmetallic materials in a supposedly solid metallic matrix. They may be less or more dense than the matrix alloy and will appear on the radiograph, respectively, as darker or lighter indications. The latter type is more common in light metal castings. Refer to [Figure 6-54](#).



H0703467

Figure 6-54. Inclusions

6.5.14.8 Sand Inclusions and Doss. Sand inclusions and doss are nonmetallic oxides, appearing on the radiograph as irregular, dark blotches, see [Figure 6-55](#). These come from disintegrated portions of mold or core walls and/or from oxides (formed in the melt) which have not been skimmed off prior to introduction of the metal into the mold gates. Careful control of the melt, proper holding time in the ladle and skimming of the melt during pouring will minimize or obviate this source of trouble.



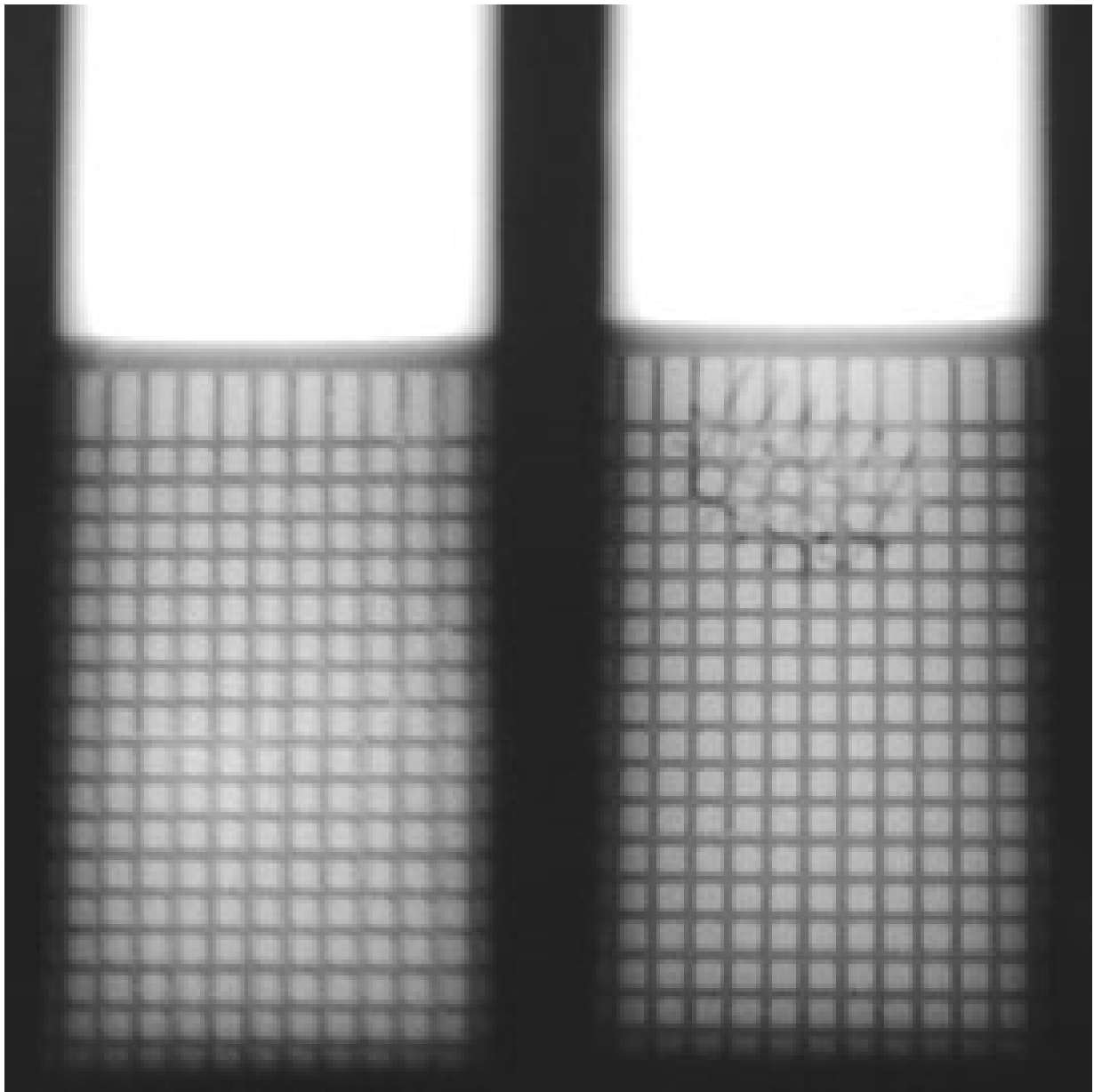
H0703468

Figure 6-55. Sand Inclusions

6.5.14.9 Cracks. Cracks are thin (straight or jagged) linearly disposed discontinuities that occur after the melt has solidified. They generally appear singly and originate at casting surfaces.

6.5.14.10 Cold Shuts. Cold shuts generally appear on or near a surface of cast metal as a result of two streams of liquid meeting and failing to unite. They may appear on a radiograph as cracks or seams with smooth or rounded edges.

6.5.14.11 Core Shift. Core shift may be detected when it is possible to angle the radiation or rotate the piece in a manner that would make it possible to measure the deviation of a specified wall thickness. Core shifts may be caused by jarring the mold, insecure anchorage, or omission of chaplets. Refer to [Figure 6-56](#).



H0703470

Figure 6-56. Core Shifts

6.5.14.12 **Hot Tears.** Hot tears are linearly disposed indications that represent fractures formed in a metal during solidification because of hindered contraction. The latter may occur due to overly hard (completely unyielding) mold or core walls. The effect of hot tears, as a stress concentration, is similar to that of an ordinary crack; hot tears are usually systematic flaws. If flaws are identified as hot tears in larger runs of a casting type, they may call for explicit improvements in technique.

6.5.14.13 **Misruns.** Misruns appear on the radiograph as prominent dense areas of variable dimensions with a definite smooth outline. They are mostly random in occurrence and not readily eliminated by specific remedial actions in the process.

6.5.14.14 **Mottling.** Mottling is a radiographic indication that appears as an indistinct area of more or less dense images. The condition is a diffraction effect that occurs on relatively vague, thin-section radiographs, most often with austenitic stain-

less steel. Mottling is caused by interaction of the object's grain boundary material with low-energy X-rays (300 kV or lower). Inexperienced interpreters may incorrectly consider mottling as indications of unacceptable casting flaws. Even experienced interpreters often have to check the condition by re-radiography from slightly different source-film angles. Shifts in mottling are then very pronounced, while true casting discontinuities change only slightly in appearance.

6.5.15 Welds. Metal may be joined together by welding to form many shapes and structures required in aircraft. This fabrication procedure, when carefully controlled, will provide a joint equal in strength to the parent materials. There must be just enough heat to produce fusion and adequate penetration, but not too much, which would cause porosity, cracks, or undercutting.

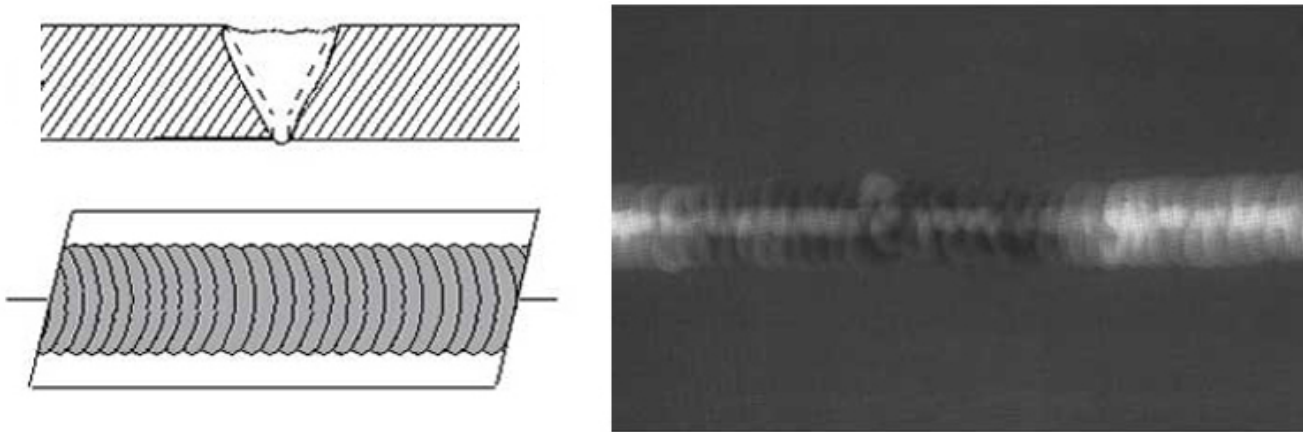
6.5.15.1 Most weld discontinuities can be readily detected by radiographic inspection since they consist of a change in material homogeneity. Cracks in welds are often detectable since they will usually occur in the direction of the thickness of the plate and will be parallel to the X-ray beam. Stresses created in the metal by welding and not accompanied by a physical separation of material will not be detected by radiography, and cracks not properly oriented may also be missed. Oxides created by the molten metal may become trapped in the weld and result in reduced strength.

6.5.15.1.1 In tungsten inert gas (TIG) welding, tungsten electrode inclusions can occur. These appear as nearly clear specks in a radiograph due to the very high absorption of the radiation by tungsten. These inclusions usually appear in clusters of two or more. A single tungsten inclusion is unusual.

6.5.15.1.2 Foreign material whose density is approximately the same as the weld metal may not be detected. In the inspection of weldments, radiography is an indispensable tool for the location of internal discontinuities. It is the oldest and best known nondestructive means for this purpose. It is used to establish welding procedures, to qualify welders, to inspect welded fabrications, and for quality control of welded parts. For routine inspection, test welds made periodically in process on production welding MAY be inspected by X-ray to supplement destructive tests where results are in doubt. When quality has been established, an occasional X-ray exposure can be made on routine work. All X-ray shadow images are geometric projections of the actual size of conditions in or on the weld. There may be some slight distortion depending on angle of X-ray beam and distance of the weld from the film. Density, in general, is some indication of the depth magnitude of the weld discontinuity.

6.5.16 Welding Defects and Conditions.

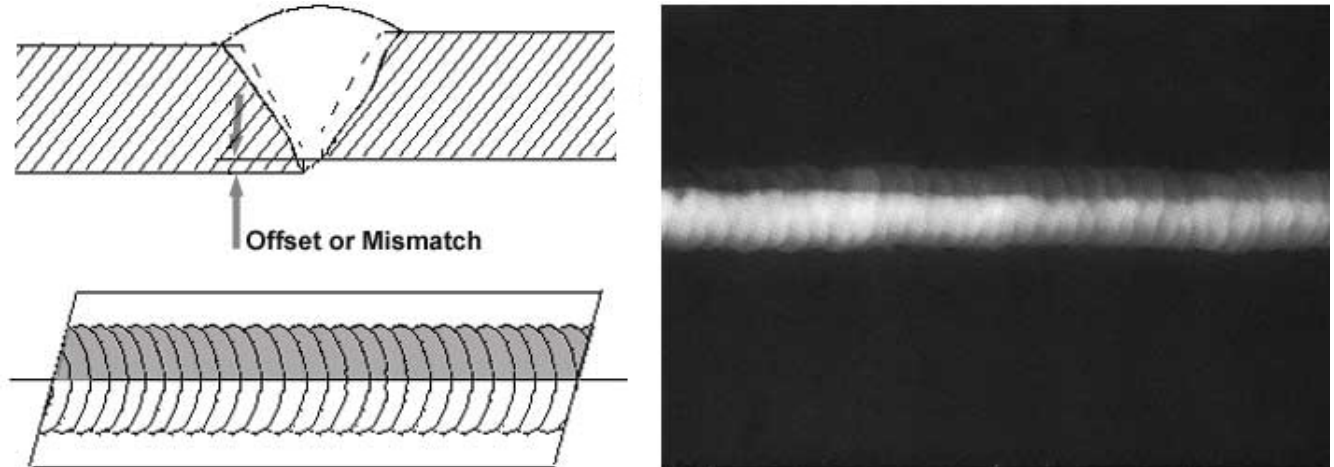
6.5.16.1 Inadequate Weld Reinforcement. Inadequate weld reinforcement is an area of a weld where the thickness of weld metal deposited is less than the thickness of the base material. See [Figure 6-57](#). It is very easy to determine by radiograph if the weld has inadequate reinforcement, because the image density in the area of suspected inadequacy will be more (darker) than the image density of the surrounding base material.



H0703471

Figure 6-57. Inadequate Weld Reinforcement

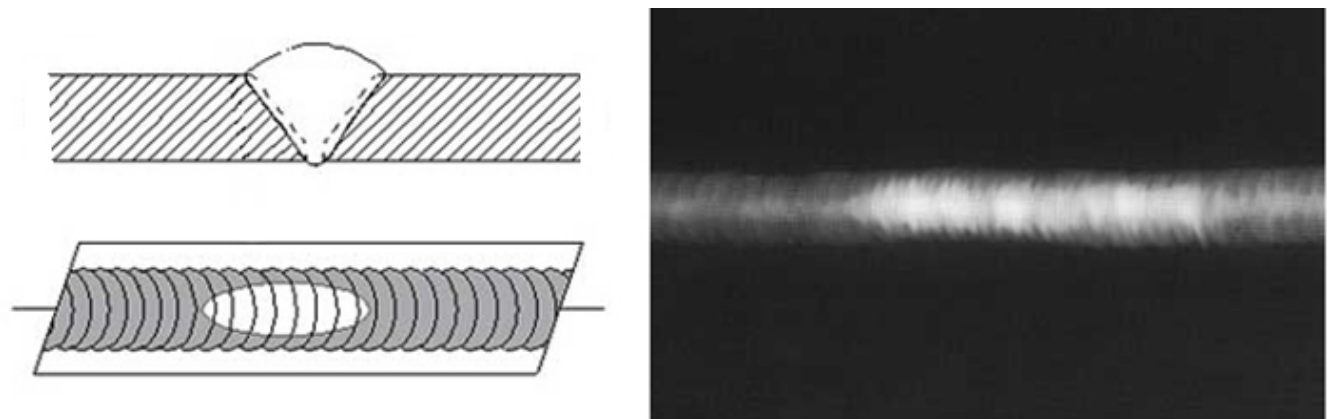
6.5.16.2 **Offset.** Offset or mismatch are terms associated with a condition where two pieces being welded together are not properly aligned. See [Figure 6-58](#). The radiographic image is a noticeable difference in density between the two pieces. The difference in density is caused by the difference in material thickness. The dark, straight line is caused by failure of the weld metal to fuse with the land area.



H0703476

Figure 6-58. Offset

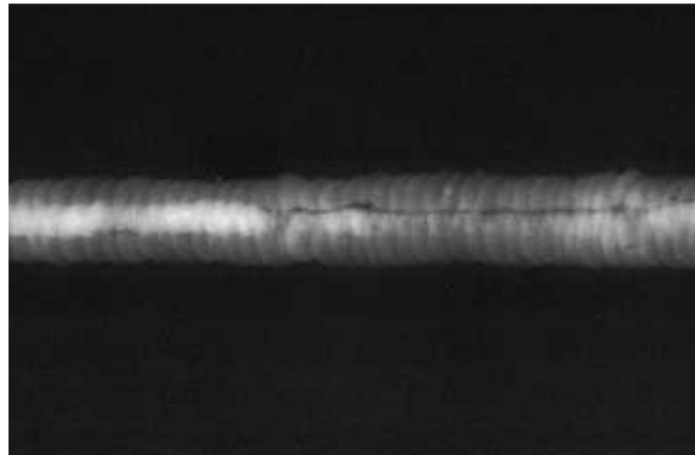
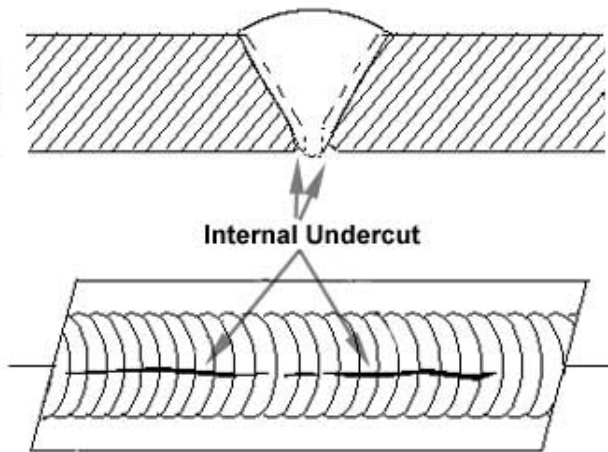
6.5.16.3 **Excessive Reinforcement.** Excess weld reinforcement is an area of a weld that has weld metal added in excess of that specified by engineering drawings and codes. The appearance on a radiograph is a localized, lighter area in the weld. A visual inspection will easily determine if the weld reinforcement is in excess of that specified by the engineering requirements. Refer to [Figure 6-59](#).



H0703477

Figure 6-59. Excessive Reinforcement

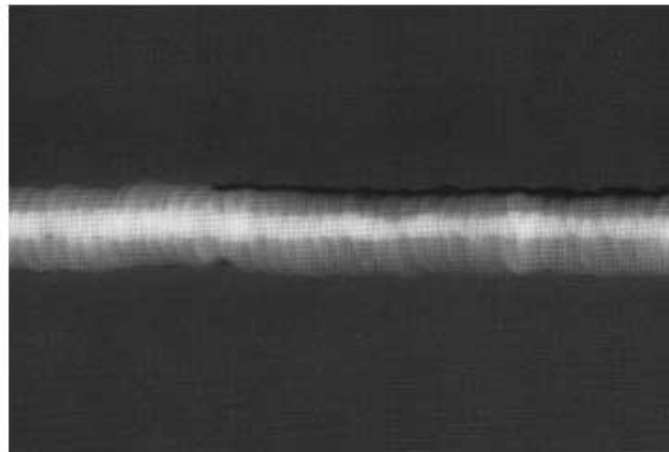
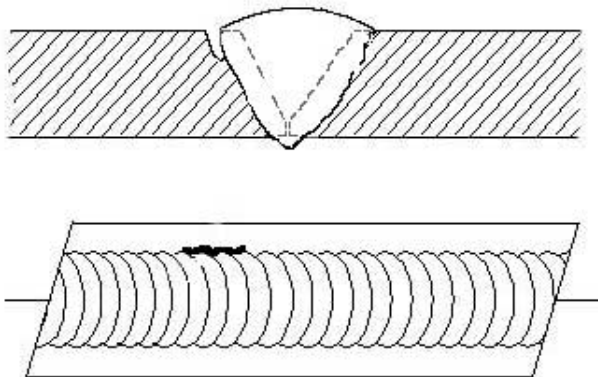
6.5.16.4 **Undercutting.** Internal or root undercut is an erosion of the base metal next to the root of the weld. In the radiographic image it appears as a dark irregular line offset from the centerline of the weldment. Undercutting is not as straight edged as lack of penetration because it does not follow a ground edge. Refer to [Figure 6-60](#).



H0703478

Figure 6-60. Internal Undercutting

6.5.16.5 External Undercut. External or crown undercut is an erosion of the base metal next to the crown of the weld. In the radiograph, it appears as a dark irregular line along the outside edge of the weld area. Refer to [Figure 6-61](#).



H0703479

Figure 6-61. External Undercutting

6.5.16.6 Suck Back. Internal concavity or suck back is a condition where the weld metal has contracted as it cools and has been drawn up into the root of the weld. On a radiograph it looks similar to lack of penetration but the line has irregular edges and it is often quite wide in the center of the weld image. Refer to [Figure 6-62](#).

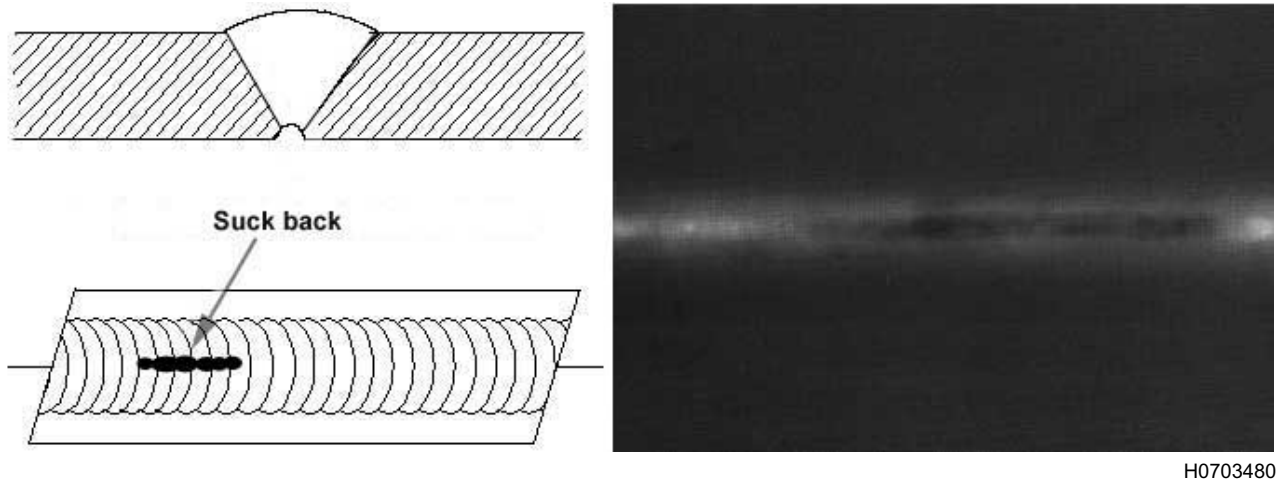


Figure 6-62. Suck Back

6.5.16.7 **Slag.** Slag inclusions are nonmetallic solid material entrapped in weld metal or between weld and base metal. In a radiograph, dark, jagged asymmetrical shapes within the weld or along the weld joint areas are indicative of slag inclusions. Refer to [Figure 6-63](#).

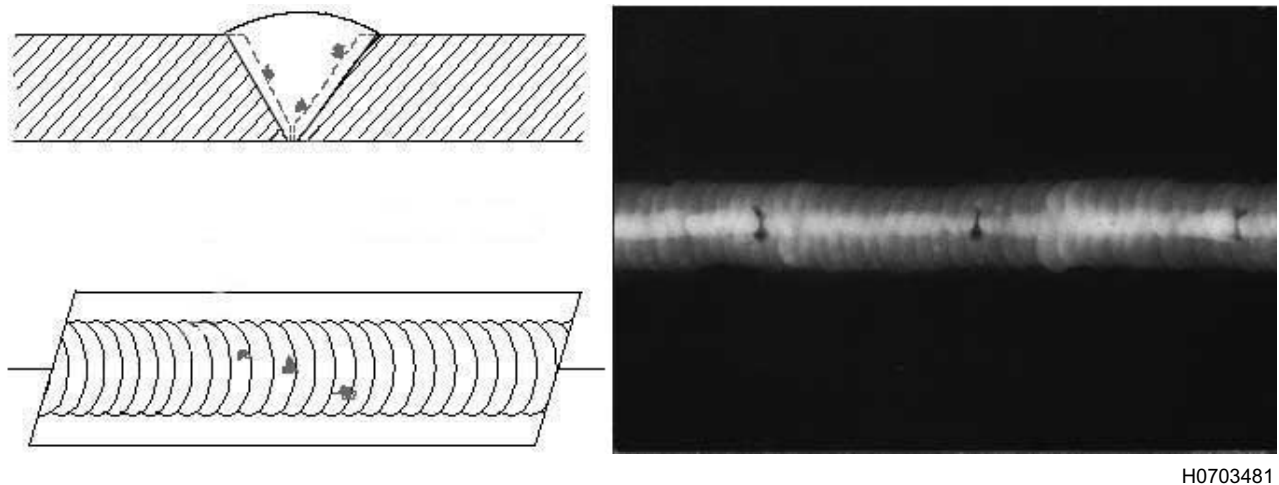
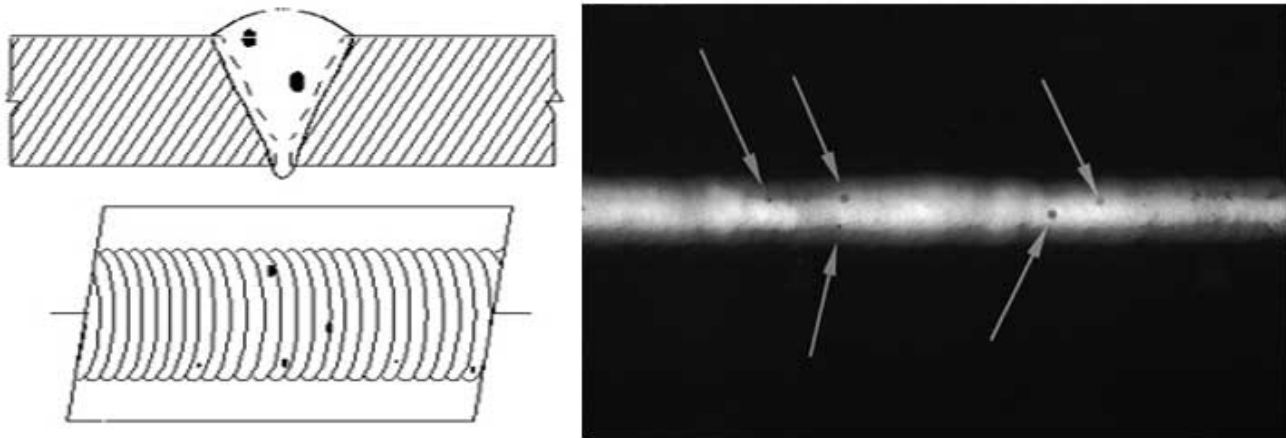


Figure 6-63. Slag Inclusions

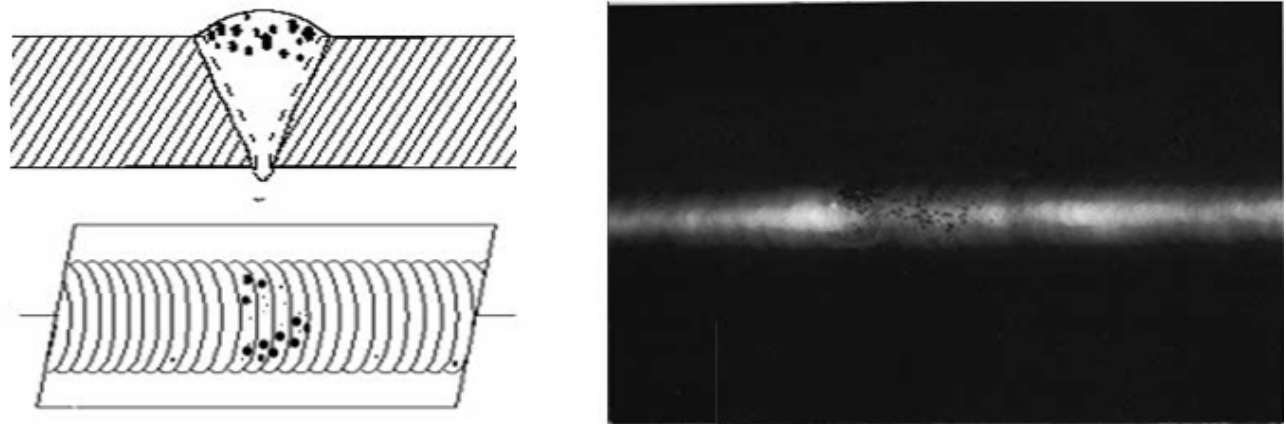
6.5.16.8 **Porosity.** Porosity is the result of gas entrapment in the solidifying metal. Porosity can take many shapes on a radiograph but often appears as dark round or irregular spots or specks appearing singularly, in clusters or rows. Sometimes porosity is elongated and may have the appearance of having a tail. This is the result of gas attempting to escape while the metal is still in a liquid state and is called wormhole porosity. All porosity is a void in the material, so it will have a radiographic density more than the surrounding area. Refer to [Figure 6-64](#).



H0703482

Figure 6-64. Porosity

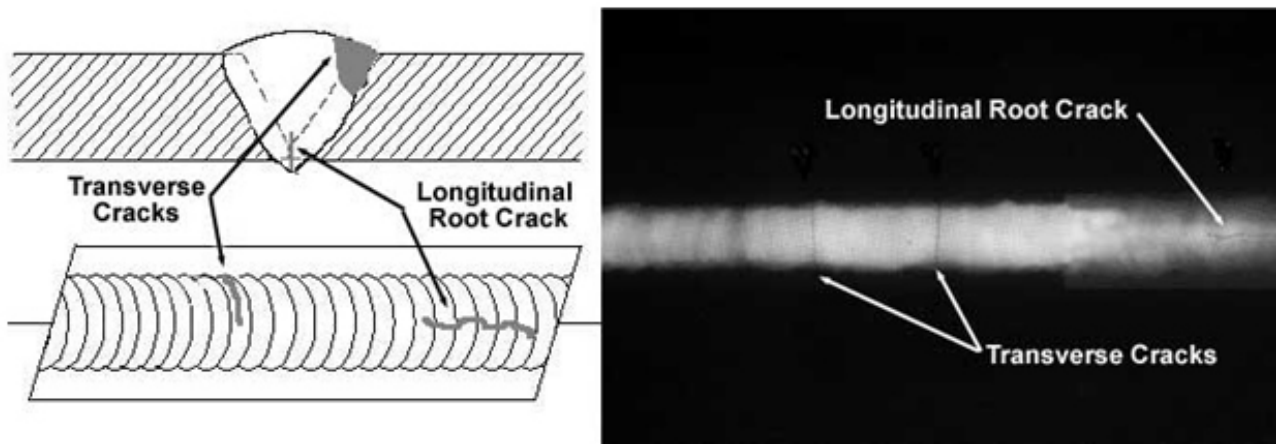
6.5.16.9 Cluster Porosity. Cluster porosity is caused when flux coated electrodes are contaminated with moisture. The moisture turns into gases when heated and becomes trapped in the weld during the welding process. Cluster porosity appear just like regular porosity in the radiograph but the indications will be grouped close together. Refer to [Figure 6-65](#).



H0703483

Figure 6-65. Cluster Porosity

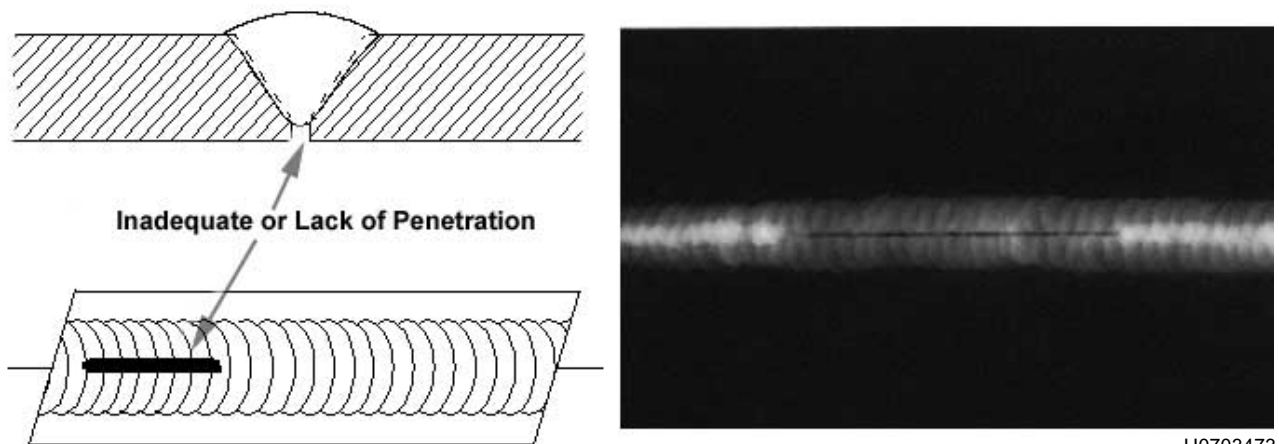
6.5.16.10 Cracks. Cracks can be detected in a radiograph only when they are propagating in a direction that produces a change in thickness that is parallel to the X-ray beam. Cracks will appear as jagged and often very faint irregular lines. Cracks can sometimes appear as “tails” on inclusions or porosity. Refer to [Figure 6-66](#).



H0703472

Figure 6-66. Cracks

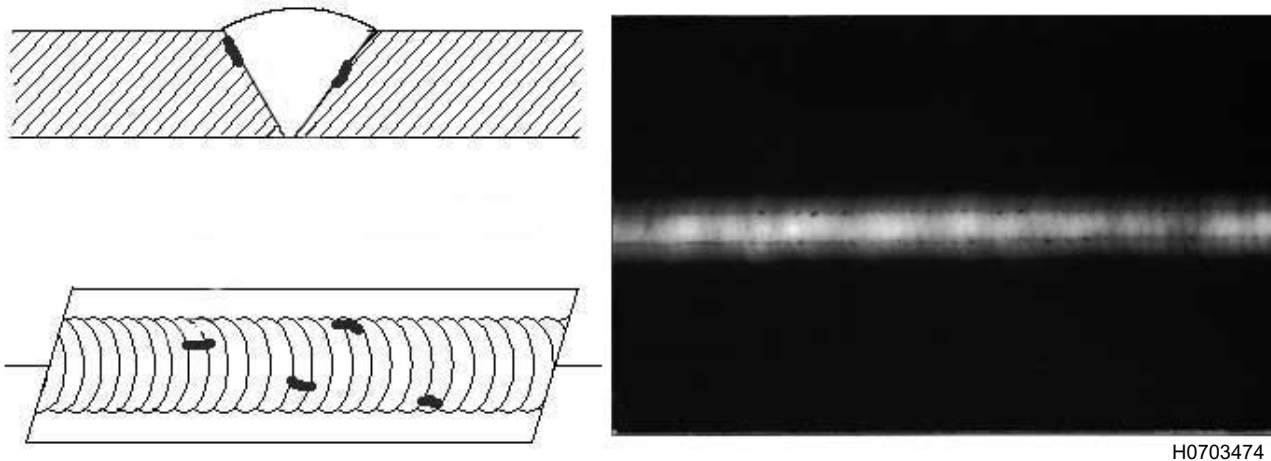
6.5.16.11 Incomplete Penetration. Incomplete penetration may occur in a fillet weld. This will show on a radiograph as dark lines along one side of weld image. Refer to [Figure 6-67](#).



H0703473

Figure 6-67. Incomplete Penetration

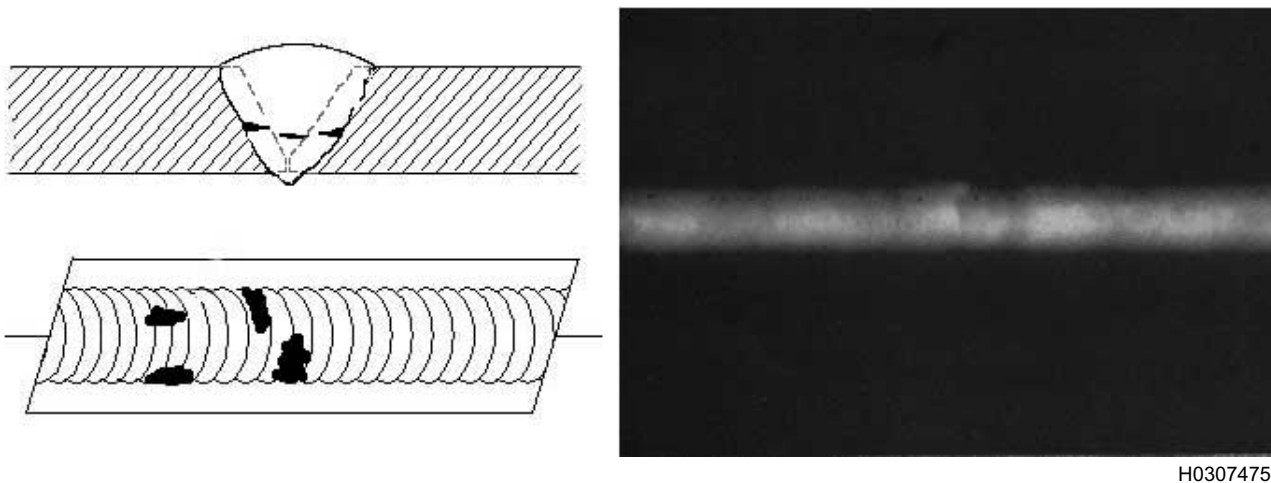
6.5.16.12 Lack of Fusion. Incomplete fusion is a condition where the weld filler metal does not properly fuse with the base metal. Appearance on radiograph: usually appears as a dark line or lines oriented in the direction of the weld seam along the weld preparation or joining area. Refer to [Figure 6-68](#).



H0703474

Figure 6-68. Lack of Fusion

6.5.16.13 **Cold Lap.** Cold Lap is a condition where the weld filler metal does not properly fuse with the base metal or the previous weld pass material (interpass cold lap). The arc does not melt the base metal sufficiently and causes the slightly molten puddle to flow into base material without bonding. Refer to [Figure 6-69](#).

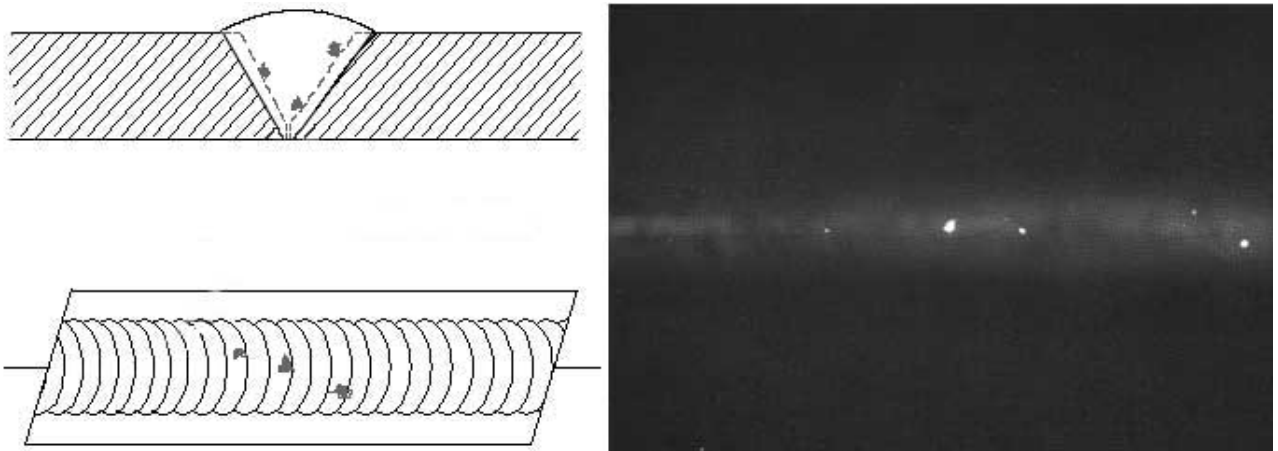


H0307475

Figure 6-69. Cold Lap

6.5.16.14 **TIG Weld Discontinuities.** The following discontinuities are peculiar to the TIG welding process. These discontinuities occur in most metals welded by the process including aluminum and stainless steels. The TIG method of welding produces a clean homogeneous weld which when radiographed is easily interpreted.

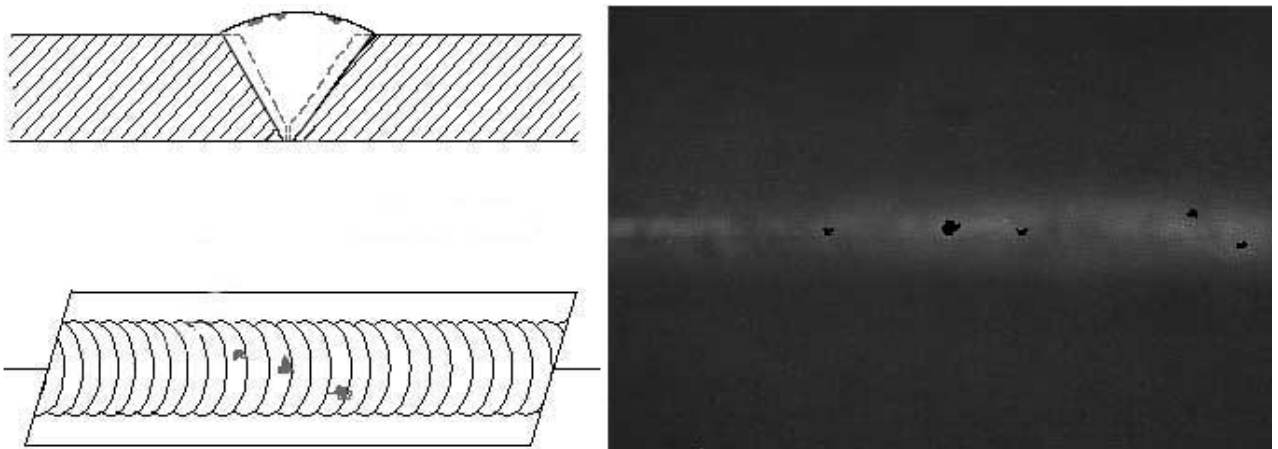
6.5.16.15 **Tungsten Inclusions.** Tungsten is a brittle and inherently dense material used in the electrode in tungsten inert gas welding. If improper welding procedures are used, tungsten may be entrapped in the weld. Radiographically, tungsten is more dense than aluminum or steel; therefore, it shows as a lighter area with a distinct outline on the radiograph. Refer to [Figure 6-70](#).



H0703488

Figure 6-70. Tungsten Inclusions

6.5.16.16 Oxide Inclusions. Oxide inclusions are usually visible on the surface of material being welded (especially aluminum). Oxide inclusions are less dense than the surrounding materials and, therefore, appear as dark irregularly shaped discontinuities in the radiograph. Refer to [Figure 6-71](#).



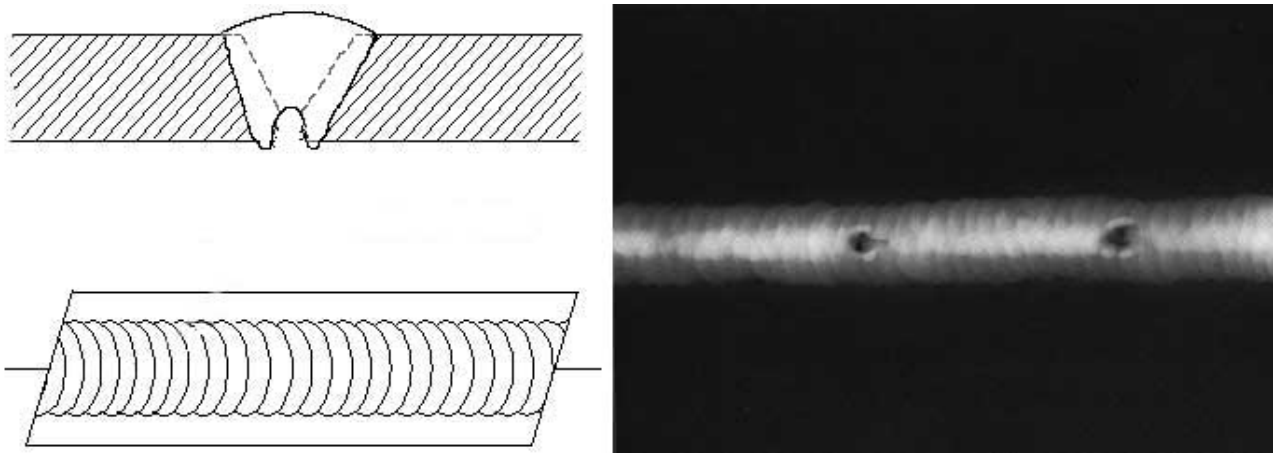
H0703484

Figure 6-71. Oxide Inclusions

6.5.16.17 Discontinuities in Gas Metal Arc Welds (GMAW). The following discontinuities are most commonly found in GMAW welds.

6.5.16.17.1 Whiskers. Whiskers are short lengths of weld electrode wire, visible on the top or bottom surface of the weld or contained within the weld. On a radiograph they appear as light, “wire like” indications.

6.5.16.17.2 Burn-Through. Burn-through results when too much heat causes excessive weld metal to penetrate the weld zone. Often lumps of metal sag through the weld creating a thick globular condition on the back of the weld. These globs of metal are referred to as icicles. On a radiograph, burn through appears as dark spots which are often surrounded by light globular areas (icicles). Refer to [Figure 6-72](#).



H0703485

Figure 6-72. Burn-Through

6.5.16.18 Aluminum and Magnesium Welds. Radiographic technique and equipment for examining welds in aluminum and magnesium alloys are no different than methods used for steel welds. The discontinuities produced by fusion welding of aluminum and revealed on film by radiography include:

- Entrapped gas, ranging from fine gas porosity to large gas holes. The porosity may be in line or at random.
- Inclusions of tungsten particles, foreign materials, flux, and oxide. Since the density of oxide films is nearly the same as aluminum, they will not produce a detailed indication on a radiograph unless present in large quantities.
- Inadequate penetration.
- Incomplete fusion.
- Cracks.
- Surface irregularities.

6.5.16.19 Spot Welds. A special exposure technique is necessary for the inspection of spot welds. The welded areas are X-rayed with a low-voltage, high-intensity, beryllium-window X-ray tube on extremely fine grained films. Spot welds and seam welds produce X-ray images of aluminum and its alloys entirely different from those of any other welding technique. Because of the rather large percentage of radiographically dense alloying constituents that produce informative patterns, some of the high strength aluminum alloys are well suited for spot weld radiography. The images show positive indications of the following:

- Variations in weld nugget shape (oversize, undersize, absence, misshapen, doughnut, and crescent shaped).
- Extrusion and expulsion of metal from nugget.
- Cracks.
- Foreign materials (for example, tip pickup).
- Porosity.
- Segregation of the alloying elements.
- Electrode impressions.

6.5.16.19.1 Flash Welds. Produce heat by creating an arc between the pieces to be joined and pressure welding, done by applying pressure to suitably prepared surfaces at temperatures lower than the melting point of the parts. Flash welds are seldom radiographically inspected. When performed, the inspection is usually made to detect cracks produced in welding procedure.

6.5.16.19.2 Incomplete Fusion. Incomplete fusion at the interfaces between weld and parent metal has certain factors in common with a crack. However, the plane of incomplete fusion is rarely normal to the plate surface, and for this reason is not always revealed. Where such a discontinuity is suspected, additional exposures at various angles may reveal the lack of fusion.

6.5.17 In-Service Inspections. When materials are utilized fully as required in the design of modern aircraft, there is occasional failure due to fatigue. These failures are results of over-stress of the material due to unusual operating conditions or deterioration of the material, such as wear, corrosion, cracks, or crack like discontinuities, water in honeycomb, foreign objects, and assembly issues. This type of material change may be the most difficult to detect due to the very nature of the changes and the inaccessibility of the areas in which these changes are most likely to occur in an aircraft. Radiography has been used to detect these conditions when they occur in inaccessible areas and are not available for visual inspection.

6.5.17.1 Wear. Rivets and bolts may wear the skin, spar, and frame holes so there is not a correct fit in the holes for adequate strength in joints or attachments of a wing section. This can occur due to continued flexing of components from use or because of severe stress due to unusual operating conditions in turbulent weather or an adverse landing. This condition may also result in radial cracks from bolt holes. This type of failure is extremely difficult to detect by radiography. Any angle of exposure results in superimposition of bolt or nut over crack. Loose bolts and rivets have been detected satisfactorily when occurring in a position to be located. Elongation of rivet holes caused by bearing failure or sheared rivets SHOULD NOT be confused with elongation of holes from drilling. If fatigue is suspected in a riveted joint, the half moon indications SHOULD all be on the same side of the rivet and the rivets in the joint SHOULD show similar indications of failure. Intermittent indications would normally be considered fabrication tolerance.

6.5.17.2 Corrosion. Corrosion may occur in aircraft materials, which reduces its strength and expedites the possible failure. This deterioration of the metal may be due to electrolytic action, moisture, chemicals, or gases which attack the metals, intergranular action due to improper heat treatment at the time of manufacture, or other factors. This condition usually occurs on internal surfaces of such components as tubular supports or housings. Since corrosion represents a change of material and occurs in all directions it is easily detected by a proper radiographic exposure. If corrosion has proceeded to this point, the support is appreciably reduced in strength and may experience failure.

6.5.17.3 Cracks and Crack-Like Discontinuities. Cracks and other crack-like discontinuities are found in numerous parts and structures. This is particularly true where structures are subjected to vibration or fatigue loading, due to propagation of these crack-like discontinuities. Cracks are very dangerous discontinuities and are the most difficult service type failure to detect by radiography, since these crack separations are usually not associated with other detectable conditions that give a clue to their presence. Crack-like discontinuities will appear in a radiograph as very straight and sharply outlined dark or black lines. Cracks may also appear as diffused jagged lines; in some cases they have a tree-like pattern. Scatter radiation from the sides of a crack can act as an amplifier of the crack image in a radiograph. Crack-like discontinuities oriented at any angle other than 90-degrees to the X-ray film and not parallel with the X-ray beam produce very little change to the radiation transmission and may not be visible in the radiographic image. Radiography can only be depended on to reveal crack-like discontinuities that are aligned within approximately 7-degrees of the X-ray beam. This depends on the thickness and width of the crack. Normally cracks that are easily detectable by X-ray are visible to the naked eye. Radiography MAY be used to determine extent of cracks or other conditions detected visually, or by magnetic particle or penetrant methods of inspection.

6.5.17.3.1 In castings, crack-like discontinuities can be due to shrinkage, hot tears, cold shuts, or other sources typical of the casting process. The forging process can introduce cracks, laps, and seams that appear crack-like in radiographic images. In weldments, longitudinal or transverse cracks may be found. Lack of weld penetration produces a crack-like discontinuity.

6.5.17.4 Water in Honeycomb. A typical condition that occurs in honeycomb structures is the formation of water in the cores. Entrapped water causes corrosion of both face sheet and core material. This entrapped water will also freeze and expand at high altitudes. This expansion distorts the cells and can break the bonds between core and facing sheets. When this condition exists, vibration of the face sheet can occur, causing failure of adjacent bonds and propagation of bond failure. Radiographic inspection is conducted to evaluate core damage and water content as a maintenance inspection. Entrapped wa-

ter in honeycomb cells usually appears as a smooth, consistent, light density area that does not have a grainy or porous appearance. The lightest area (more dense substance) indicates greater amounts of water.

6.5.17.4.1 Epoxy in honeycomb cells appears grainy, non-homogeneous. If the cell is not spotty and completely filled, the epoxy will be located around the periphery of each cell.

6.5.17.4.2 Radiographic inspection for moisture detection can be made with the honeycomb core cell walls in either the vertical or horizontal plane. The preferred method is with the core cell walls in the horizontal plane because core cells which are partially filled with moisture are more readily identifiable (less easily confused with solid adhesive).

6.5.17.4.3 If practical, confirmation of partially filled cells with water can be made by repeating the radiographic procedure with the honeycomb cell walls in the opposite plane.

6.5.17.4.4 Radiographic exposures indicating filled core cells are not always conclusive for moisture detection and SHOULD be confirmed by other means if possible.

6.5.17.5 Foreign Objects. Radiography is an excellent method to locate and evaluate foreign objects. Foreign objects MAY be free rivets, bolts, or other objects that could be detrimental to the function of the part or assembly.

6.5.17.6 Workmanship. Radiographic inspections, after completion of repair, assure quality of workmanship. On occasion components are misassembled. In some areas it is not possible to check dimension by physical or visual means. Radiography MAY be used if precautions are taken to assure proper geometrical relation to determine dimension of internal spacing.

6.5.18 Assemblies. Radiography has found wide use in the reevaluation of various assemblies to determine status or condition. If the use of the assembly produces changes in it, which are recordable by an X-ray beam, then radiography may be useful in supplying confirming evidence of the suspected condition. Radiographic inspection of oil coolers has resulted in an inspection method that can detect foreign material in the cooler.

6.5.19 Radiographic Standards. It is inherent to good practice, in many cases, that castings or weldments are thicker in cross section than required for the necessary strength of the part. For this reason, some flaws in the casting can be tolerated with no detrimental effect to the aircraft. In order to determine what castings or weldments are acceptable for use in an aircraft, standards of acceptability are prepared as a guide to the radiographer. There are two general types of standards prepared; the specific standard applicable to only one particular part and the general standard.

6.5.19.1 A specific standard for a part is prepared by X-raying the part and then destructively testing the part by applying force of the same type and direction as would be expected in actual service. If the yielding force is greater than the design load, the X-ray film of the part MAY be used as a standard. These types of standards are normally used by foundries and copies of these standards are limited in supply since the part is destroyed by testing and additional retakes cannot be made.

6.5.19.1.1 General standards are prepared by an engineering society, company, or government agency as a guide in determining if the casting and weldments are sound. These standards are based on experience and engineering judgment to provide a casting and weldment generally acceptable for normal use. Radiographic standards prepared by the American Society for Testing and Materials (ASTM) International, 100 Barr Harbor Dr., P.O. Box C700, West Conshohocken, PA 19428-2959 are approved for use.

6.5.19.1.2 Paints, sealants, and adhesives used in fabricating structures often build up to thicknesses readily observed on radiographs. Radiographic indications of these materials can result in obliterating the area of concern and/or cause misinterpretation of the radiograph. The method of application and the built up thickness causes a very rough surface of widely varying thicknesses. The radiographic indication often appears similar to a radiograph of a weld bead. The materials in the liquid or gel state can entrap foreign particles, such as metal chips or gas bubbles. These cause radiographic indications similar to inclusions or porosity. During curing, drying, or service, the organic material can form crack patterns. Radiographic indications of the cracks can appear as dry mud cracks, dendrites (tree branches), or one or two very wide cracks. The indications are difficult to interpret and require substantial experience to evaluate. Cracks in coating materials are normally recognized by the crack pattern and the fact that the crack will exceed normal or usual metal crack width. The best method of confirming these indications is to remove the paint, sealant, or adhesive and to X-ray again. Unfortunately, limited access does not always permit coating removal. Triangulation can be used to define the location of the indication as being on top of the structure.

SECTION VI PROCESS CONTROL OF RADIOGRAPHIC INSPECTION

6.6 RADIOGRAPHIC PROCESS CONTROL.

6.6.1 Scope and Purpose. Process control of radiography or any of the other NDI methods means variables involving materials, equipment, personnel, and documentation are well defined and maintained. This means that the features which are significant in terms of process reliability be identified so controls can be put in place.

6.6.2 Radiographic Process Control Requirements. Although the entire X-ray process must be closely controlled to produce the expected results, this requirement centers on film processing. The novice might think X-ray is a cure all, but to the informed it is a very costly and sometimes inaccurate NDI method. X-ray procedures SHOULD be followed precisely. Proper beam alignment, the correct film, source focal spot size, and correct exposure parameters are critical. This radiographic process has many factors that affect the quality of the final product.

6.6.2.1 During radiographic inspection/exposure parameters requiring control include: variations in the radiation source, voltage, current, heat removal, geometry factors (i.e., focal spot size, shape, and location), beam collimation and direction, source-to-object, source to film/detector distances, and object to film detector distances.

6.6.2.2 Variables to be controlled during radiographic film storage include: handling and processing the film, screens, cassettes, and chemicals. For the most part, process control of these variables is dependent on the radiographer and the care the inspector uses in setting up all these features. Good record keeping of the entire process is important in maintaining reliability.

6.6.3 Process Control in the Darkroom. Darkroom design is discussed in [Paragraph 6.4.5](#), but the design is critical toward controlling the radiographic process. The darkroom SHALL be completely protected against radiation and visible light. For efficiency and reducing the possibility of damaging radiographic film, two distinct areas SHOULD be established within the darkroom. One area SHOULD be designated the “dry area” and the other the “wet area.” The dry area is where film is unloaded and placed on hangers, prepared to be loaded in the automatic film processor, loaded in cassettes, or cut to support special inspections. Liquids or materials that could damage unprotected film SHOULD NOT be allowed in this area. The wet area is where development chemicals are mixed and hand development is accomplished. Wet hangers and other wet equipment SHOULD NOT be permitted out of this area of the darkroom. These two areas SHOULD be physically separated to prevent the wet chemicals from being accidentally transferred to the film loading areas, causing spots or other artifacts on the film.

6.6.3.1 If possible, the dark room SHOULD adjoin the X-ray room or radiographic work area. A film-transfer cabinet SHOULD be installed in the separating wall, particularly if a large volume of work is done. Film can then be handled efficiently without interfering with darkroom processing. The film-transfer cabinet SHALL be lead lined if it adjoins the X-ray room.

6.6.3.2 Ventilation. Proper ventilation of the darkroom SHALL be determined by a bioenvironmental engineer or Health Physicist. The circulation of clean fresh air will reduce fatigue and provide a healthier atmosphere for personnel. Light-tight ventilators SHALL be installed and the number will depend on the size of the darkroom. Ventilators SHOULD keep the air moving from the dry side to the wet side of the room and out of the building.

6.6.3.3 Safelights. To minimize the fogging of undeveloped radiographic film by the safelights in the darkroom, the following provisions apply:

- General illumination SHALL be indirect.
- Safelights SHOULD be suspended from the ceiling and SHALL be at least four feet from undeveloped/exposed film.
- Only the minimum level of safelights needed to perform darkroom operations SHALL be allowed.
- Only safelight filters (6B or equivalent) designated for use with industrial radiographic film SHALL be allowed.
- The manufacturer’s recommended bulb wattage SHALL NOT be exceeded.

- The darkroom walls SHOULD be painted a light color, which best reflects light from the safelight. The darkroom SHOULD have an antechamber type entrance that makes an efficient light trap.
- During the development and preparation of uncovered, undeveloped radiographic film, ambient light SHALL NOT exist in the darkroom.

6.6.3.3.1 Why Test Safelights. The level of safelight present in the darkroom SHALL be the minimum required to perform undeveloped film preparation/development operations. Safelights for darkroom operation contribute to unwanted densities (fog) on radiographic film. To overcome this problem, the length of time undeveloped industrial radiographic film can safely be exposed to the level of safelight within a specific darkroom SHALL be understood. This time period is much shorter for exposed film than for unexposed film. The reason for this time difference is exposed film is approximately five times more susceptible to fog caused by safelights than unexposed film.

6.6.3.3.1.1 The safelight fog evaluation procedure consists of two tests: the individual safelight test and the periodic collective safelight test. These tests have a requirement to be performed separately or jointly depending upon the circumstances. Both of these tests SHALL be performed during initial safelight evaluation for a new or in-use darkroom facility whenever the periodic collective safelight test results are unacceptable. Procedures for performing the safelight fog test are published in TO 33B-1-2 SWP 106 07.

6.6.3.3.2 Individual Safelight Testing. Circumstances when this test SHALL be performed are:

- Initial test on newly installed safelights.
- Changes are made to existing lights such as replacing entire units, bulbs, filters, or changing the position (e.g. reflecting versus direct lighting).
- Filters are suspected of fading or being adversely affect by damage like crazing, scratches, and cracks.
- Collective safelight test results are unsatisfactory.
- A safelight is suspect of producing excessive safelight fog.

NOTE

The maximum time undeveloped film can be exposed to safelight shall be posted in the darkroom in an area clearly visible to all radiographers.

6.6.3.3.3 Periodic Collective Safelight Testing . Periodic collective safelight filters deteriorate during use. This rate of deterioration is dependent on their age, amount of use, and amount of heat generated by the bulb. Therefore, a periodic schedule SHALL be established to collectively test safelights to prevent film fog, dependent upon their use. Circumstances, which determine when this test SHALL be performed, are 1) during the periodic test cycle, which SHALL NOT exceed one- year, and 2) repositioning safelights, 3) when reestablishing an undeveloped film handling area, and 4) when installing additional safelights. The collective safelight test film SHALL be maintained on file for one year or replaced when the test is performed again.

6.6.3.3.4 Troubleshooting if Failure to Meet Standards . If maximum allowable time undeveloped film can be exposed to safelights is 4-minutes and 45-seconds or less, or not suitable for operational needs, one or more of the following actions SHALL be taken:

1. Replace safelight filters that are faded, cracked, are not designated for industrial radiographic film, crazed, do not fit properly, or scratched.
2. Replace safelight bulbs exceeding the wattage recommended by the safelight manufacturer.
3. Replace unserviceable safelights, such as those still emitting ambient light after filter and bulb problems have been corrected.

4. Eliminate or reconfigure uncontrollable ambient light sources such as doorways, ventilating and heating ducts/vents, faulty film pass through box, building structural cracks, and holes around pipes and electrical wiring.
5. In the event the individual safelight tests are all within an acceptable tolerance, but the collective safelight test is unacceptable, investigate, the validity of the individual safelight test and when, in fact, the results of these tests are correct, reduce the number of safelights in the darkroom.

6.6.4 Controlling the Development Process.

6.6.4.1 Control Strip. A major variable in the radiographic process is the processing of the film. The chemical concentrations, contaminants, and temperature are important variables which affect the process. A method of monitoring changes during film processing involves periodically processing many control-exposed films to detect changes in film density and/or contrast. Procedure is located in TO 33B-1-2 SWP 106 07. The last strip in the control exposure SHOULD be processed with the control film of the new batch to maintain continued control from month to month. In cases where films from one manufacturer are processed in another film manufacturer's recommended solutions, the period between control tests may need to be shortened.

6.6.4.1.1 The radiographic inspector SHALL use the control strip to detect changes in the radiographic process. If the inspector ensures the equipment is properly maintained, takes care to use the equipment in a repeatable manner, maintains good records, and maintains the repeatability of film processing, then the radiographic inspection process will remain in good control.

6.6.4.2 Manual Processing Chemicals. Although the shape of the characteristic curve is relatively insensitive to changes in X-ray or gamma-ray quality, it is affected by changes in degree of development. Degree in development depends on the type of developer, temperature, degree of activity, and the time of development. Within certain limits, increased degree of development increases the speed and contrast of an X-ray film. However, if development is carried to far, the speed of the film may cease to increase and may even decrease. The result is the fog increases and contrast may decrease.

6.6.4.2.1 Testing Developer Activity. The success of this method of compensating for the gradual decrease of developer activity will depend upon the use of an adequate system for testing this activity. Since there is no simple direct physical or chemical test of developer activity, the easiest way of making the test is to process, at frequent intervals, film strips exposed in some standard manner, and to compare the densities obtained with an identical film strip processed in the fresh solution. The standard strips are cut from a sheet film, 8x10 inches or larger, which has been exposed to direct X-rays through a test object. The most suitable form of test object is a stepped wedge made up of a number of sheets of any convenient metal. The wedge SHOULD have about 15 steps and be large enough to cover completely the largest cassette or film holder used. When given the proper exposure this SHOULD produce series of densities extending over the density range used in practice. It is essential all strips used in testing a batch of developer receive identical exposures. For this reason, no screens of any kind are used and all the sheets of film required SHOULD be exposed simultaneously in the same cassette. For instance, at 80 kilovolts, using an aluminum step tablet, three sheets MAY be exposed in the same cassette without introducing significant differences in the densities of the top and bottom films. At 180 kilovolts, using a steel tablet, five sheets MAY be exposed at once. At 1000 kilovolts, a steel tablet having steps 1/4- to 1/2- inches high can be used, and five sheets of film exposed at once. When this penetrating radiation is used, two extra films are included, and the top and bottom films are discarded after exposure. The exposed films SHOULD be stored in a cool/dry place (ideally, at 70°F and 50-percent relative humidity, or below). When manually processing test strips, they SHOULD be developed dark end down on regular film-processing hangers in the center of the tank and be given the same development time and agitation used in practice.

6.6.4.2.2 Stop Bath Acidity. The stop bath acidity is not as critical as developer activity, but a check can be made with litmus paper to assure the bath is acidic and capable of neutralizing the alkaline developer.

6.6.4.2.3 Fixer Bath Activity. The diminished activity of the fixer solution with use in manual processing can be readily noted by the extended time required for clearing of the film emulsion. Fixer time can be increased to compensate for deterioration of the chemicals or chemicals MAY be replenished by addition of the chemical constituents of the fixer.

6.6.4.3 Automatic Processing Chemicals. Automatic processors and their chemicals are designed to give the optimum degree of development. All the variables that affect the degree of development are controlled and kept constant by the processor. The responsibilities of the operator are to keep the machine clean and to make sure that temperatures and replenishment rates are maintained at proper levels.

6.6.4.3.1 Control of Processing Solutions. It is rare when chemicals manufactured under exactly the same conditions possess precisely the same properties. In actuality, differences exist. Accordingly, it is unavoidable, X-ray films processed in automatic processors show some degree of variation in quality. Radiographic quality is affected by the following factors, making it necessary to minimize such variations in the control of processing solutions.

6.6.4.3.2 Developer Control. The activity level of the developer solution used in automatic processing is kept constant by the addition of replenisher. The degree of exhaustion of the active components may differ from case-to-case depending on the type of processor, the average density of the radiographs, and the water quality, even if the quantities of film processed remain constant. Process the film lengthwise to avoid losing the film in the rollers. When a new batch of developer is put into use, one or more strips are processed and preserved as the standard for comparison throughout the useful life of the developer. Thereafter, a strip SHOULD be processed after every 50, 14x17-inch films or equivalent processed or 5-gallons of developer. If the densities of the test strip are less than those of the strip processed in the fresh solution, the rate of addition of replenisher SHOULD be increased. On the other hand, if the densities of the test strips are too high, the rate of addition of replenisher SHOULD be decreased.

6.6.4.3.2.1 Even when the same replenishment rates are used in different facilities, the activity of the developer solutions differs over time from one situation to another. The developer solution SHOULD therefore be controlled in a manner suited to the specific conditions of the particular facility. Developer solution is controlled in several ways, but in radiography the "sensitometric" and "densitometric" methods are in general use as control procedures.

6.6.4.3.2.1.1 Sensitometric Method. This method provides the highest control accuracy. A control strip which is exposed to visible light or X-rays in step fashion is developed under predetermined conditions and a characteristic curve is derived from this control strip. The characteristic values (of speed, contrast, and fog) obtained from the characteristic curve are graphically represented. If the characteristics of the control strip deviate from normal, corrective action is taken to bring the developer solution into control. In practice, the characteristics obtained from fresh developer are used as the standard and a control strip is processed after processing a certain number of films or at the beginning of each work shift (at the time processing conditions are stabilized following processor preparation).

6.6.4.3.2.1.2 Densitometric Method. The densitometric method also uses control strips. The density of a specific step of relatively high density is used to plot a control chart. The control film is processed at the same specified time as indicated for the sensitometric control method.

6.6.4.3.3 Fixer Control. An exhausted fixer solution will produce adverse effects relative to the permanency of radiographs. It is necessary to check the fixer solution for exhaustion once per month, or when regular processor maintenance is performed. Fresh chemicals are metered into the processor as film is processed and it is this replenishment that keeps the solution active. The normal replenishment rates for auto-fixers are 170 to 190 ml per 14x17 film processed. Fixer process control checks SHALL be performed in accordance with Operating/Maintenance Manual recommendations.

SECTION VII RADIOGRAPHIC INSPECTION EQUATIONS

6.7 RADIOGRAPHIC EQUATIONS.

6.7.1 General. The following are a list of equations normally used to perform radiographic inspections.

6.7.2 Exposure Factor. A quantity that combines milliamperage with time and distance. Techniques are often provided in terms of kilovoltage and exposure factor. In such cases, it is necessary to determine the time from the milliamperere-minutes or milliamperere-seconds. $\text{Exposure factor} = (\text{Time} \times \text{Milliamperes}) / \text{Distance}^2$

6.7.2.1 mAM. To obtain the exposure time from mAM, divide mAM by the mA used. This will give the time in minutes. Multiply the 10 hundredths of a minute by 60 to get the answer in minutes/seconds format. For example:

100 kV, 17 mAM

If 4 mA is used:

$17 / 4 = 4.25$ minutes

0.25 (= 25 hundredths of a minute) X 60 = 15

Time would be 4 minutes, 15 seconds

6.7.2.2 **mAS**. To obtain the exposure time from mAS, divide mAS by the mA used. This will give the time in seconds. Divide by 60 to obtain the time in minutes. Then divide the 10 hundredths of the minute by 60 to get exact seconds. For example:

100 kV, 525 mAS
 If 4 mA is used:
 $525 / 4 = 131.25$ seconds
 $131.25 / 60 = 2.19$
 0.19 (= 19 hundredths of a minute) X 60 = 11
 Time would be 2 minutes, 11 seconds

6.7.3 **Inverse Square Law**. When the X-ray tube output is held constant, or when a particular radioactive source is used, the radiation intensity reaching the specimen is governed by the distance between the tube (source) and the specimen, varying inversely with the square of this distance. The explanation below is in terms of X-rays and visible light, but applies with equal force to gamma rays as well. Since X-rays conform to the laws of light, they diverge when they are emitted from the anode and cover an increasing larger area with lessened intensity as they travel from their source. This principle is illustrated by [Figure 6-26](#).

6.7.3.1 In this example, it is assumed the intensity of the X-rays emitted at the anode (A) remains constant, and the X-rays passing through the aperture (B), cover a 4-square-inch area upon reaching and recording surface (C1), which is 12-inches (D_1) from (A). If the recording surface (C1) is moved 12-inches farther from the anode to (C2), so the distance between (A) and (C2) is 24-inches (D_2) or twice the distance between (A) and (C1); the X-rays will cover 16-square-inches, an area four-times as great as that at (C1). Therefore, the radiation-per-square-inch on the surface at (C2) is only one-quarter that at (C1). Thus the exposure that would be adequate at (C1) must be increased four-times in order to produce a radiograph at (C2) of equal density. In practice this is done by increasing either the time, or milliamperage. Mathematically the inverse square law is expressed as follows:

$$\frac{I_1}{I_2} = \frac{(D_2)^2}{(D_1)^2}$$

where I_1 and I_2 are the intensities at distances D_1 and D_2 respectively.

6.7.4 **Source-to-Film Distance (SFD)**. The sharpest image would be formed by having a SFD so great the radiation would be parallel at the film plane ([Figure 6-23](#)), however, since radiation intensity or quantity is diminished in relationship to the inverse square of the distance, the radiation quantity available to expose the film would be very small, and exposure times would become impractical. Consequently, economics and practicability must be considered when producing a radiographic image. It is recommended the longest practical SFD be used for critical exposures to improve image sharpness. If the source-to-film distance is changed, the following formula can be used to correct the exposure. Because an increase in distance causes a decrease in beam intensity, only the intensity is changed. The kilovoltage SHALL NOT be changed when correcting for SFD changes.

The formula is: $\frac{T_2}{(D_2)^2} = \frac{T_1}{(D_1)^2}$ $T_2 = T_1 \left(\frac{D_2}{D_1} \right)^2$ or $\frac{T_1 (D_2)^2}{(D_1)^2}$

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Where:

T_1 = Original Exposure (MAS).

T_2 = New Exposure (MAS).

D_1 = Original Distance (SFD).

D_2 = New Distance (SFD).

For example, if a technique calls for exposing a part at 36-inches using 300 MAS, but the tube head must be moved to make a 48-inch SFD, what would the new exposure be?

Substituting:

Cross multiplying gives $(T_2) * (1296) = (300) * (2304)$ or $T_2 = (300 * 2304)/1296$.

Solving, $T_2 = 533$ MAS, which would be our new exposure.

6.7.5 Film Density. In photographic terms, density is a measure of the degree of blackening or darkening produced on the radiograph, caused by exposure to radiation and resulting from the metallic silver deposits remaining on the film after exposure and processing. Density is measured in terms of visible light transmission with test strips. The accepted scale of film density measurement is the logarithm of the reciprocal of the fraction of incident light to transmitted light as given by the following equation:

$$D = \log \frac{I_0}{I_t}$$

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Where:

D = film image density.

I_0 = original light intensity falling upon one surface of film.

I_t = light intensity transmitted through the film.

For example, an increase in the amount of blackening from one area of a particular film to another, reduces the proportion of the incident light transmitted from 50 to 25-percent would cause the film density to change from 0.3 to 0.6.

6.7.5.1 More examples of typical relationships between light transmission and density are in [Table 6-3](#). A typical density used in practical radiography is 2.0 and represents 1-percent transmittance. Density is measured with densitometers and test strips ([Paragraph 6.5.5.1](#)).

6.7.6 Logarithms for Density and Exposure Calculations. Logarithms are used extensively in X-ray exposure calculations and in the measurement of X-ray film density. Radiographers SHALL be sufficiently familiar with logarithms so they can perform some simple calculations. A brief review of logarithms and their use is therefore included here. More detail can be found in various handbooks and intermediate mathematics texts. Logarithms are used because they provide a convenient method of handling very large ranges of numbers, and they reduce calculations involving multiplication and division to addition and subtraction. The logarithm is the power (or exponent) to which the base must be raised to give the original number. Logarithms MAY be taken from any base; however, most calculations in radiography involve either the base 10 or the base e (2.718). Logarithms to the base 10 are indicated by "log x ," and logarithms to the base e are denoted by "ln x ." For the moment, let us consider logarithms to the base 10: $\log 100 = 2$, because $10^2 = 100$. Similarly, the logarithm of 1,000 is 3 or: $\log 1,000 = 3$, since $10^3 = 1,000$. The logarithms of all numbers that are integer powers of 10 (e.g., 10, 100, 1,000, etc.) are whole numbers (1, 2, 3, etc.). Logarithms of other numbers are decimal numbers and are found in tables of logarithms or calculated on some hand calculators. A table of four-place logarithms to the base 10 is given in [Table 6-22](#). The logarithm is made up of two basic parts, the "characteristic," which is the number before the decimal point and the "mantissa," which is the number after the decimal point. The characteristic indicates the order of magnitude of the number x ; for example, numbers 10 through 99 have a characteristic of 1. Characteristics for other ranges are given in [Table 6-21](#). The digits of the number determine the mantissa. In [Table 6-22](#), the mantissa of 328, for example, find by going to the number 32 along the left hand side and looking across that row under the column marked "8." We see in the table the mantissa of 328 is given as 5159. What is the logarithm of 328? It can be seen the characteristic of 328 would be 2 ([Table 6-21](#)). Therefore, $\log 328$ is equal to 2.5159.

Table 6-21. Characteristics of Logarithms

Number	Characteristic
1	0
10	1
100	2
1,000	3
10,000	4

NOTE

The value of the characteristic is one less than the number of digits in the number.

Table 6-22. Four-Place Logarithms to the Base 10

N	0	1	2	3	4	5	6	7	8	9		0	1	2	3	4	5	6	7	8	9
10	0000	0043	0086	0128	0170	0212	0253	0294	0334	0374	55	7404	7412	7419	7427	7435	7443	7451	7459	7466	7474
11	0414	0453	0492	0531	0569	0607	0645	0682	0719	0755	56	7482	7490	7497	7505	7513	7520	7528	7536	7543	7551
12	0792	0828	0864	0899	0934	0969	1004	1038	1072	1106	57	7559	7566	7574	7582	7589	7597	7604	7612	7619	7627
13	1139	1173	1206	1239	1271	1303	1335	1367	1399	1430	58	7634	7642	7649	7657	7664	7672	7679	7686	7694	7701
14	1461	1492	1523	1553	1584	1614	1644	1673	1703	1732	59	7709	7716	7723	7731	7738	7745	7752	7760	7767	7774
15	1761	1790	1818	1847	1875	1903	1931	1959	1987	2014	60	7782	7789	7796	7803	7810	7818	7825	7832	7839	7846
16	2041	2048	2095	2122	2148	2175	2201	2227	2253	2279	61	7853	7860	7868	7875	7882	7889	7896	7903	7910	7917
17	2304	2330	2355	2380	2405	2430	2455	2480	2504	2529	62	7924	7931	7938	7945	7952	7959	7966	7973	7980	7987
18	2553	2577	2601	2625	2648	2672	2695	2718	2742	2765	63	7993	8000	8007	8014	8021	8028	8035	8041	8048	8055
19	2788	2810	2833	2856	2878	2900	2923	2945	2967	2989	64	8062	8069	8075	8082	8089	8096	8102	8109	8116	8122
20	3010	3032	3054	3075	3096	3118	3139	3160	3181	3201	65	8129	8136	8142	8149	8156	8162	8169	8176	8182	8189
21	3222	3243	3263	3284	3304	3324	3345	3365	3385	3404	66	8195	8202	8209	8215	8222	8228	8235	8241	8248	8254
22	3424	3444	3464	3483	3502	3522	3541	3560	3579	3598	67	8261	8267	8274	8280	8287	8293	8299	8306	8312	8319
23	3617	3636	3655	3674	3692	3711	3729	3747	3766	3784	68	8325	8331	8338	8344	8351	8357	8363	8370	8376	8382
24	3802	3820	3838	3856	3874	3892	3909	3927	3945	3962	69	8388	8395	8401	8407	8414	8420	8426	8432	8439	8445
25	3979	3997	4014	4031	4048	4065	4082	4099	4116	4133	70	8451	8457	8463	8470	8476	8482	8488	8494	8500	8506
26	4150	4166	4183	4200	4216	4232	4249	4265	4281	4298	71	8513	8519	8525	8531	8537	8543	8549	8555	8561	8567
27	4314	4330	4346	4362	4378	4393	4409	4425	4440	4456	72	8573	8579	8585	8591	8597	8603	8609	8615	8621	8627
28	4472	4487	4502	4518	4533	4548	4564	4579	4594	4609	73	8633	8639	8645	8651	8657	8663	8669	8675	8681	8686
29	4624	4639	4654	4669	4683	4698	4713	4728	4742	4757	74	8692	8698	8704	8710	8716	8722	8727	8733	8739	8745
30	4771	4786	4800	4814	4829	4843	4857	4871	4886	4900	75	8751	8756	8762	8768	8774	8779	8785	8791	8797	8802
31	4914	4928	4942	4955	4969	4983	4997	5011	5024	5038	76	8808	8814	8820	8825	8831	8837	8842	8848	8854	8859
32	5051	5065	5079	5092	5105	5119	5132	5145	5159	5172	77	8865	8871	8876	8882	8887	8893	8899	8904	8910	8915
33	5185	5198	5211	5224	5237	5250	5263	5276	5289	5302	78	8921	8927	8932	8938	8943	8949	8954	8960	8965	8971
34	5315	5328	5340	5353	5366	5378	5391	5403	5416	5428	79	8976	8982	8987	8993	8998	9004	9009	9015	9020	9025
35	5441	5453	5465	5478	5490	5502	5514	5527	5539	5551	80	9031	9036	9042	9047	9053	9058	9063	9069	9074	9079
36	5563	5575	5587	5599	5611	5623	5635	5647	5658	5670	81	9085	9090	9096	9101	9106	9112	9117	9122	9128	9133
37	5682	5694	5705	5717	5729	5740	5752	5763	5775	5786	82	9138	9143	9149	9154	9159	9165	9170	9175	9180	9186
38	5798	5809	5821	5832	5843	5855	5866	5877	5888	5899	83	9191	9196	9201	9206	9212	9217	9222	9227	9232	9238
39	5911	5922	5933	5944	5955	5966	5977	5988	5999	6010	84	9243	9248	9253	9258	9263	9269	9274	9279	9284	9289
40	6021	6031	6042	6053	6064	6075	6085	6096	6107	6117	85	9294	9299	9304	9309	9315	9320	9325	9330	9335	9340
41	6128	6138	6140	6160	6170	6180	6191	6201	6212	6222	86	9345	9350	9355	9360	9365	9370	9375	9380	9385	9390
42	6232	6243	6253	6263	6274	6284	6294	6304	6314	6325	87	9395	9400	9405	9410	9415	9420	9425	9430	9435	9440
43	6335	6345	6355	6365	6375	6484	6493	6503	6513	6522	89	9494	9499	9504	9509	9513	9518	9523	9528	9533	9538
45	6532	6542	6551	6561	6571	6580	6590	6599	6609	6618	90	9542	9547	9552	9557	9562	9566	9571	9576	9581	9586
46	6628	6637	6646	6656	6665	6675	6684	6693	6702	6712	91	9590	9595	9600	9605	9609	9614	9619	9624	9628	9633
47	6721	6730	6739	6749	6758	6767	6776	6785	6794	6803	92	9638	9643	9647	9652	9657	9661	9666	9671	9675	9680
48	6812	6821	6830	6839	6848	6857	6866	6875	6884	6893	93	9685	9689	9694	9699	9703	9708	9713	9717	9722	9727
49	6902	6911	6920	6928	6937	6946	6955	6964	6972	6981	94	9731	9736	9741	9745	9750	9754	9759	9763	9768	9773
50	6990	6998	7007	7016	7024	7033	7042	7050	7059	7067	95	9777	9782	9786	9791	9795	9800	9805	9809	9814	9818
51	7076	7084	7093	7101	7110	7118	7126	7135	7143	7152	96	9823	9827	9832	9836	9841	9845	9850	9854	9859	9863
52	7160	7168	7177	7185	7193	7202	7210	7218	7226	7235	97	9868	9872	9877	9881	9886	9890	9894	9899	9903	9908
53	7243	7251	7259	7267	7275	7284	7292	7300	7308	7316	98	9912	9917	9921	9926	9930	9934	9939	9943	9948	9952
54	7324	7332	7340	7348	7356	7364	7372	7380	7388	7396	99	9956	9961	9965	9969	9974	9978	9983	9987	9991	9996
N	0	1	2	3	4	5	6	7	8	9	N	0	1	2	3	4	5	6	7	8	9

*Interpolation in this section of the table is inaccurate.

Table 6-23. Antilogarithms

	0	1	2	3	4	5	6	7	8	9		0	1	2	3	4	5	6	7	8	9
.00	1000	1002	1005	1007	1009	1012	1014	1016	1019	1021	.50	3162	3170	3177	3184	3192	3199	3206	3214	3221	3228
.01	1023	1026	1028	1030	1033	1035	1038	1040	1042	1045	.51	3236	3243	3251	3258	3266	3273	3281	3289	3296	3304
.02	1047	1050	1052	1054	1057	1059	1062	1064	1067	1069	.52	3311	3319	3327	3334	3342	3350	3357	3365	3373	3381
.03	1072	1074	1076	1079	1081	1084	1086	1089	1091	1094	.53	3388	3396	3404	3412	3420	3428	3436	3443	3451	3459
.04	1096	1099	1102	1104	1107	1109	1112	1114	1117	1119	.54	3467	3475	3483	3491	3499	3508	3516	3524	3532	3540
.05	1122	1125	1127	1130	1132	1135	1138	1140	1143	1146	.55	3548	3556	3565	3573	3581	3589	3597	3606	3614	3622
.06	1148	1151	1153	1156	1159	1161	1164	1167	1169	1172	.56	3631	3639	3648	3656	3664	3673	3681	3690	3698	3707
.07	1175	1178	1180	1183	1186	1189	1191	1194	1197	1199	.57	3715	3724	3733	3741	3750	3758	3767	3776	3784	3793
.08	1202	1205	1208	1211	1213	1216	1219	1222	1225	1227	.58	3802	3811	3819	3828	3837	3936	3945	3954	3963	3972
.10	1259	1262	1265	1268	1271	1274	1276	1279	1282	1285	.60	3981	3990	3999	4009	4018	4027	4036	4046	4055	4064
.11	1288	1291	1294	1297	1300	1303	1306	1309	1312	1315	.61	4074	4083	4093	4102	4111	4121	4130	4140	4150	4159
.12	1318	1321	1324	1327	1330	1334	1337	1340	1343	1346	.62	4169	4178	4188	4198	4207	4217	4227	4236	4246	4256
.13	1349	1352	1355	1358	1361	1365	1368	1371	1374	1377	.63	4266	4276	4285	4295	4305	4315	4325	4335	4345	4355
.14	1380	1384	1387	1390	1393	1396	1400	1403	1406	1409	.64	4365	4375	4385	4395	4406	4416	4426	4436	4446	4457
.15	1413	1416	1419	1422	1426	1429	1432	1435	1439	1442	.65	4467	4477	4487	4498	4508	4519	4529	4539	4550	4560
.16	1445	1449	1452	1455	1459	1462	1466	1469	1472	1476	.66	4571	4581	4592	4603	4613	4624	4634	4645	4656	4667
.17	1479	1483	1486	1489	1493	1496	1600	1503	1507	1510	.67	4677	4688	4699	4710	4721	4732	4742	4753	4764	4775
.18	1514	1517	1521	1524	1528	1531	1535	1538	1542	1545	.68	4786	4797	4808	4819	4831	4842	4853	4864	4875	4887
.19	1549	1552	1556	1560	1563	1567	1570	1574	1578	1581	.69	4898	4909	4920	4932	4943	4955	4966	4977	4989	5000
.20	1585	1589	1592	1596	1600	1603	1607	1611	1614	1618	.70	5012	5023	5035	5047	5058	5070	5082	5093	5105	5117
.21	1622	1626	1629	1633	1637	1641	1644	1648	1652	1656	.71	5129	5140	5152	5164	5176	5188	5200	5212	5224	5236
.22	1660	1663	1667	1671	1675	1679	1683	1687	1690	1694	.72	5248	5260	5272	5284	5297	5309	5321	5333	5346	5358
.23	1698	1702	1706	1710	1714	1718	1722	1726	1730	1734	.73	5370	5383	5395	5408	5420	5433	5445	5458	5470	5483
.24	1738	1742	1746	1750	1754	1758	1762	1766	1770	1774	.74	5495	5508	5521	5534	5546	5559	5572	5585	5598	5610
.25	1778	1782	1786	1791	1795	1799	1803	1807	1811	1816	.75	5623	5630	5649	5662	5675	5689	5702	5715	5728	5741
.26	1820	1824	1828	1832	1837	1841	1845	1849	1854	1858	.76	5754	5768	5781	5794	5808	5821	5834	5848	5861	5875
.27	1862	1866	1871	1875	1879	1884	1888	1892	1897	1901	.77	5888	5902	5916	5929	5943	5957	5970	5984	5998	6012
.28	1905	1910	1914	1919	1923	1928	1932	1936	1941	1945	.78	6026	6039	6053	6067	6081	6095	6109	6124	6138	6152
.29	1950	1954	1959	1963	1968	1972	1977	1982	1986	1991	.79	6166	6180	6194	6209	6223	6237	6252	6266	6281	6295
.30	1995	2000	2004	2009	2014	2018	2023	2028	2032	2037	.80	6310	6324	6339	6353	6368	6383	6397	6412	6427	6442
.31	2042	2046	2051	2056	2061	2065	2070	2075	2080	2084	.81	6457	6471	6486	6501	6516	6531	6546	6561	6577	6592
.32	2089	2094	2099	2104	2109	2113	2118	2123	2128	2133	.82	6607	6622	6637	6653	6668	6683	6699	6714	6730	6745
.33	2138	2143	2148	2153	2158	2163	2168	2173	2178	2183	.83	6761	6776	6792	6808	6823	6839	6855	6871	6887	6902
.34	2188	2193	2198	2203	2208	2213	2218	2223	2228	2234	.84	6918	6934	6950	6966	6982	6998	7015	7031	7047	7063
.35	2239	2244	2249	2254	2259	2265	2270	2275	2280	2286	.85	7079	7096	7112	7129	7145	7161	7178	7194	7211	7228
.36	2291	2296	2301	2307	2312	2317	2323	2328	2333	2339	.86	7244	7261	7278	7295	7311	7328	7345	7362	7379	7396
.37	2344	2350	2355	2360	2366	2371	2377	2382	2388	2393	.87	7413	7430	7447	7464	7482	7499	7516	7534	7551	7568
.38	2399	2404	2410	2415	2421	2427	2432	2438	2443	2449	.88	7586	7603	7621	7638	7656	7674	7691	7709	7727	7745
.39	2455	2460	2466	2472	2477	2483	2489	2495	2500	2506	.89	7762	7780	7798	7816	7834	7852	7870	7889	7907	7925
.40	2512	2518	2523	2529	2535	2541	2547	2553	2559	2564	.90	7943	7962	7980	7998	8017	8035	8054	8072	8091	8110
.41	2570	2576	2582	2588	2594	2600	2606	2612	2618	2624	.91	8128	8147	8166	8185	8204	8222	8241	8260	8279	8299
.42	2630	2636	2642	2649	2655	2661	2667	2673	2679	2685	.92	8318	8337	8356	8375	8395	8414	8433	8453	8472	8492
.43	2692	2698	2704	2710	2716	2723	2729	2735	2742	2748	.93	8511	8531	8551	8570	8590	8610	8630	8650	8670	8690
.44	2754	2761	2767	2773	2780	2786	2793	2799	2805	2812	.94	8710	8730	8750	8770	8790	8810	8831	8851	8872	8892
.45	2818	2825	2831	2838	2844	2851	2858	2864	2871	2877	.95	8913	8933	8954	8974	8995	9016	9036	9057	9078	9099
.46	2884	2891	2897	2904	2911	2917	2924	2931	2938	2944	.96	9120	9141	9162	9183	9204	9226	9247	9268	9290	9311
.47	2951	2958	2965	2972	2979	2985	2992	2999	3006	3013	.97	9333	9354	9376	9397	9419	9441	9462	9484	9506	9528
.48	3020	3027	3034	3041	3048	3055	3062	3069	3076	3083	.98	9550	9572	9594	9616	9638	9661	9683	9705	9727	9750
.49	3090	3097	3105	3112	3119	3126	3133	3141	3148	3155	.99	9772	9795	9817	9840	9863	9886	9908	9931	9954	9977

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Table 6-24. Effect of Relative Exposure on Film Sensitivity

Change in Relative Exposure	Change in Density
0.5 to 1.0	0.3 to 0.7
1.0 to 1.5	0.7 to 1.5
1.5 to 2.0	1.5 to 3.0

6.7.6.1 Logarithms provide a convenient method of multiplying and dividing. To multiply two numbers, you take the logarithms of both numbers and add them to get the logarithm of the product. To obtain the product, you then take the antilogarithm of this sum. The antilog is the inverse function of the log. In other words, the antilog of x is equal to 10^x . The antilogs for mantissas of 0.000 to 0.999 are listed in [Table 6-23](#). The value of x is then obtained by properly placing the decimal point according to the characteristic of the sum of the logarithms.

Example: Multiply 20 times 8 using logarithms.

- (1) Take the log of 20: $\log 20 = 1.3010$
- (2) Take the log of 8: $\log 8 = 0.9031$
- (3) Take the sum of these logarithms: $1.301 + 0.9031 = 2.2041$
- (4) Take the antilog of the sum:

The antilog of 0.2041 = 1600

The characteristic of 2 indicates a number between 100 and 999.

Therefore the answer is 160.

In this example, the regular mathematical calculation is simple, however, with very large numbers, the use of logarithms significantly simplifies calculation.

6.7.6.1.1 Division is accomplished by taking the difference between the logs of the two numbers. Example: $6/73 = \text{antilog}(\log 6 - \log 73)$.

6.7.6.2 In radiography, logarithms find particular use in the preparation of exposure charts and in film characteristic curves which plot film density against relative exposure. Logarithms to the base 10 MAY be converted to natural logarithms by the equation $\ln x = 2.3 \log x$.

6.7.7 **Material Contrast Factor.** In consideration to radiation absorption, the most important variable that can be controlled by the radiographer in industrial X-ray inspection is the kilovoltage. The amount of radiation absorbed by the part being inspected depends on the atomic number, density, and thickness of the material. The radiographer cannot change these factors, but can change the energy of radiation in the attenuation equation:

$$I = I_0 e^{-\mu x}$$

The linear attenuation coefficient (μ) can be changed by changing radiation energy. This in turn will change the percentage radiation transmitted through a part of thickness, x . In industrial radiographic applications, the difference in thickness (often due to discontinuities) is the actual parameter from which interpretation is made. Therefore, the greater the change in the radiation transmitted due to a particular change in material thickness, the more obvious is the thickness change revealed in the final image. This radiation difference due to material thickness change is called the material contrast. The material contrast is a function of the absorption characteristics of the part being inspected and the radiation energy level. When measurements have been made and a numerical value has been established, it is called the material contrast factor.

6.7.8 **Image Unsharpness.** This is the term applied recognizing there will always be unsharpness of the image to some degree, and perfect image sharpness is unattainable. The amount of geometric image unsharpness is due to size of the source of radiation and relative distances as shown in [Figure 6-23](#). The distance on the film over which an edge is spread is known as the penumbral shadow or the geometrical unsharpness, U_g . The value of U_g does not enter into other computations; it sets the upper limit for Ft/d . The value must be determined experimentally. The equation to determine unsharpness is:

$$U_g = Ft/d$$

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where:

F = maximum dimension of the focal spot

t = distance from the source side of the test object to the film

d = distance from the source to object

6.7.8.1 In considering geometrical unsharpness, recognize the value of new microfocus X-ray sources and the potential for geometric magnification. A nomogram is used to assist in solving this equation for various geometrical conditions ([Figure 6-24](#)). Note that 3 out of 4 terms in the equation must be known before it can be used.

6.7.8.2 Suppose a specimen having a maximum thickness of 1.5-inches (t) is to be radiographed at 20-inch source-to-film distance (SFD) (d) using a source of effective focal size 6mm. The need is to establish an approximate value for U_g . The steps in using the nomogram are:

- a. Plot the points A and C that represent the known value of F and t. The pivot line is intersected at B.
- b. Plot a line joining point D (the value of d) and B. The extension of this line at E gives the value of U_g (0.47mm).

6.7.9 Heel Effect. For simplicity's sake, most literature states the intensity of radiation of the primary beam is constant, this is not quite correct. There is a variation in intensity due to the angle at which X-rays are emitted from the focal spot. This variation in intensity is called the heel effect ([Figure 6-12](#)).

6.7.9.1 The intensity of the beam diminishes rapidly from the central ray toward the anode side and increases slightly toward the cathode side. In general practice the heel effect is not evident, provided the maximum lateral dimension of the object to be radiographed is less than half the source-to-film distance (SFD). In other words, coverage of a 14 x 17-inch film requires an SFD of approximately 36-inches to provide a field intensity of plus or minus 12-percent over the entire film. This is based upon using part of the radiation field within a cone having a 30-degree included angle. Remember, the source for an X-ray tube is the focal spot. For a single exposure of larger areas requiring multiple films, the SFD must be increased. For example, to determine the SFD to cover an area that fits within a circle, which has a diameter of 56-inches, do the following calculation:

$$SFD = \frac{R}{\tan\theta}$$

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θ equals the half-angle of the cone = 15-degrees

Tan 15 = 0.268

R = one-half the diameter = 28-inches

Therefore, SFD = $\frac{28}{0.268} = 104.5\text{-inches}$

If the SFD is limited, the radius of beam coverage can be calculated by rearranging the formula:

$$R = \tan\theta \times SFD$$

Using the same cone half-angle of 15-degrees, $\tan\theta = 0.268$

Assume the SFD is limited to 60-inches

$$R = 0.268 \times 60 = 17\text{-inches}$$

If the radiographer must radiograph an area larger than a 34-inch diameter circle, more than one setup must be used.

SECTION VIII AIR FORCE RADIOGRAPHIC INSPECTION SAFETY

6.8 SCOPE AND PURPOSE OF RADIATION PROTECTION.

6.8.1 General.

NOTE

Each branch of service has specific requirements governing radiation safety. Navy and Marine Corp radiographic operations are governed by NAVSEA S0420-AA-RAD-010. Air Force radiographic operations are governed by [Paragraph 6.8.2](#) - [Paragraph 6.8.8.4.9](#).

- a. This section is intended to serve as a guide to the safe use of X-ray sources for industrial radiographic purposes. It provides guidance to persons who use these sources and to others who may have a responsibility for their use. It recommends operational procedures, personnel controls, and radiation protection practices to eliminate needless exposure of personnel to ionizing radiation. In addition, it provides criteria for the guidance of qualified personnel for the design or modification of industrial radiographic X-ray installations.
- b. The word "SHALL" identifies requirements necessary to meet the standards of protection of this section. The word "SHOULD" indicates advisory recommendations to be applied when practical.
- c. The provisions of this section incorporate provisions of Title 10, Code of Federal Regulations, Parts 19-21, and 34, Air Force Instruction (AFI) 21-101, Air Force Manuals (AFMAN) 48-148, 91-203, Department of the Air Force Manual (DAFMAN) 48-125, and miscellaneous policy statements. Although the provisions incorporated herein are correct at the time of issuance, users SHOULD review these federal, Air Force regulations periodically to assure compliance with current regulations. This section is based in part on recommendations contained in HPS ANSI/HPS N43.3 "For General Radiation Safety – Installations Using Non-Medical X-Ray and Sealed Gamma-Ray Sources, Energies Up to 10 MeV", and in National Council on Radiation Protection and Measurement (NCRP) Report No. 116, *Limitation of Exposure to Ionizing Radiation, and NCRP Report No. 51, Radiation Protection Design Guidelines for 0.1-100 MeV Particle Accelerator Facilities*. Exposure limits specified herein are derived from those specified in federal regulations, particularly Title 10, Code of Federal Regulations, (10 CFR) Part 20. In the event of conflict, the more restrictive limits apply.

6.8.2 Responsibilities.

6.8.2.1 Installation Radiation Safety Officer (IRSO). The IRSO is responsible for the following, in addition to those requirements and responsibilities outlined in AFMAN 48-148:

- a. The IRSO is responsible for initiation, supervision, and execution of the Installation Radiation Protection Program. This program provides for routine health physics surveillance of all operations involving the use of ionizing radiation to ensure safe practices. Consultant services of qualified individuals are available at USAFSAM/OEC, 2510 Fifth St, Area B-Building 840, Wright-Patterson AFB OH 45433, DSN 798-3764, Commercial 937-938-3764 and ESOH Service Center 888-232-3764 to assist the IRSO with the radiation protection program.
- b. The IRSO annually performs a comprehensive assessment of all aspects of the Radiation Safety Program and operational procedures. The IRSO will determine the need for additional surveys, safety precautions, administrative or physical controls. The IRSO will document findings, recommendations, and restrictions and forward copies to the Unit Commander and the radiography supervisor.
- c. The IRSO provides As Low as Reasonably Achievable (ALARA) training in accordance with 10 CFR 19 and 29 CFR 1910 to assist radiography supervisors.
- d. The IRSO surveys exposures in controlled and uncontrolled areas as required by [Paragraph 6.8.4.5](#).
- e. The IRSO assists in any investigations of overexposures, abnormal exposures, or incidents involving radiation exposures resulting from NDI operations.

- f. The IRSO ensures contract radiography services are conducted in accordance with applicable state and federal regulations, and the requirement of this technical order.
- g. The IRSO establishes appropriate action levels for personnel dosimetry results, such that, if this level is exceeded an investigation will result to assess the cause and minimize future occurrences.
- h. The IRSO assists deploying radiographers with determining whether a comprehensive Radiation Safety Program exists at the deployed location and what steps, if any, need to be taken prior to deployment. The IRSO will assist URSO in contacting the appropriate offices to perform scatter surveys or annual assessments if required. The IRSO in the AOR (or COCOM/MAJCOM BEE affiliated with AOR) will have AF radiation safety oversight for the AOR.
- i. The IRSO assesses all malfunctioning/non-compliant radiation safety equipment and facilities being used to conduct radiographic operations. The IRSO will determine if a Risk Assessment Codes (RAC) need to be assigned IAW AFI 91-202 and provide any guidance on what action is required to ensure compliance.

6.8.2.2 **Unit Commander.** The Unit Commander ensures that the Nondestructive Inspection Laboratory, its facilities, and the radiation protection program fulfill the requirements of AFI 21-101, AFMAN 48-148, DAFMAN 48-125, and this document.

6.8.2.3 **Unit Radiation Safety Officer (URSO).** The NDI Laboratory Supervisor will normally be delegated the responsibility for administering all industrial radiography operations and ensuring compliance with all aspects of the Radiation Safety Program. If the NDI Laboratory Supervisor does not meet the qualifications in [Paragraph 6.8.3.1](#) the responsibility SHALL be delegated to a qualified person. The Unit Radiation Safety Officer (URSO) is appointed by the Unit Commander and SHALL:

6.8.2.3.1 Determine and periodically check the competency of industrial radiographers.

6.8.2.3.2 Ensure radiation producing equipment and power safety-switch key are placed in secure areas separate from one another.

6.8.2.3.3 Ensure newly assigned workers are provided initial radiation safety training (see [Paragraph 6.8.3.2.2](#)) and ALARA training (see [Paragraph 6.8.3.2.2.2](#)) and thereafter, receive annual refresher training.

6.8.2.3.4 Develop and maintain current radiological safety operating procedures (see [Paragraph 6.8.6.1.2](#), [Paragraph 6.8.6.2.3](#) and [Paragraph 6.8.6.2.3.2.2](#)). Operating procedures SHALL be maintained with the radiation producing equipment and will be annually reviewed for currency.

6.8.2.3.5 Develop and maintain a current emergency procedure (see [Paragraph 6.8.4.5.2](#)). The emergency procedure SHALL be maintained with the radiation producing equipment and will be annually reviewed for currency.

6.8.2.3.6 Maintain, as a minimum, two separate utilization log books; (see [Paragraph 6.8.7.1](#)) one for shielded areas and the other for unshielded areas (if areas not utilized, a book is not required).

6.8.2.3.7 Procure and maintain adequate radiation survey instruments and personnel monitoring devices. Establishes robust radiation survey instrument and personnel monitoring device calibration programs, which including a staggered calibration schedule.

6.8.2.3.8 Maintain exposure devices, radiography facilities, and associated equipment.

6.8.2.3.9 Ensure personnel are entered into the personnel monitoring program and promote proper wear and use of devices.

6.8.2.3.10 Assume control and institute corrective actions in emergency situations.

6.8.2.3.11 Investigate, in coordination with the IRSO, the cause of incidents that result in suspected overexposures and unnecessary radiation exposures and determine necessary action to prevent recurrence and maintain all radiation exposures "As Low As Reasonably Achievable" (ALARA).

6.8.2.3.12 Ensure compliance with the requirements of 10 CFR 34 when conducting or overseeing contract operations involving sealed sources.

6.8.2.3.13 Ensures the personnel comply with all mandatory operating procedures as established in this TO and all locally generated safety operating instructions.

6.8.2.3.14 Determines whether a comprehensive Radiation Safety Program exists at deployed locations and what steps, if any, need to be taken prior to deployment. With assistance from the home-station IRSO, contacts the appropriate offices to perform scatter surveys or annual assessments if required.

6.8.2.3.15 The URSO SHALL contact the IRSO regarding any malfunctioning/non-compliant radiation safety equipment and facilities being used to conduct radiographic operations. The organization SHALL comply with the guidance provided by the IRSO on what action is required to ensure compliance.

6.8.2.4 Radiographer in Charge. The radiographer in charge (RIC) is a qualified radiographer and SHALL be identified prior to performing the inspection. This person is normally senior in grade and will ensure all radiation safety monitors and radiation safety monitor assistants understand their duties while performing the inspection. RIC duties include:

- a. Supervision of radiation safety monitors and assistants to ensure a safe inspection.
- b. Following all mandatory operating procedures as established in this TO and all locally generated safety operating instructions.
- c. Ensuring compliance with the Radiation Protection Survey and all approved operating procedures.
- d. Ensuring utilization logs are correctly filled out.

6.8.2.5 Radiation Safety Monitors. Radiation safety monitors are qualified radiographers who work under the direct supervision of the radiographer in charge. Duties include:

- a. Operating radiation survey meters.
- b. Establishing location of radiation barriers.
- c. Setting up personnel barriers.
- d. Preventing unauthorized personnel from entering a radiation area.
- e. Recording radiation intensity reading at barriers.
- f. Recording doses from dosimeters.
- g. Utilizing dosimetry devices as specified by the Radiation Safety Officer.
- h. Performing other duties as directed by the radiographer in charge.

6.8.2.5.1 Radiation Safety Monitors Assistants. Radiation Safety Monitor Assistants are those persons who assist the radiographer and/or the Radiation Safety Monitor in preventing unauthorized access into radiographic inspection areas. Safety assistants SHALL NOT be authorized inside the radiation area during irradiation. Assistants will be stationed outside the radiation area, but in such a location as to allow them to monitor the barrier and prevent barrier penetration. Assistants SHOULD always be in direct vision or contact with the safety monitor or radiographers to effect radiation termination if required. Assistants will receive their instructions directly from the RIC or the Radiation Safety Monitor, but not from the other assistant. Training requirements are located in [Paragraph 6.8.2.5.1.1](#). Duties include:

- a. Operating radiation survey meters.
- b. Assisting with setting up personnel barriers.

- c. Preventing unauthorized personnel from entering a radiation area.
- d. Wearing a OSL dosimeter and/or EPD if specified by the IRSO.

6.8.2.5.1.1 Training for Radiation Safety Monitor Assistants. Assistants SHALL receive, as a minimum, radiation safety training covering the following items: properties of X-ray radiation, hazards of excessive exposure to radiation, methods of measuring radiation, radiation protection, and operation of specific measurement devices that will be used. This training SHALL be conducted by a qualified radiographer, Bioenvironmental Engineer or Radiation Safety Officer and documented in the individual's training record or the Maintenance Information System (MIS). Refresher training SHALL be conducted annually.

6.8.3 Qualifications and Training For Industrial Radiography.

6.8.3.1 Unit Radiation Safety Officer (URSO) Qualification. NDI personnel who meet the following qualifications maybe designated as the URSO (see [Paragraph 6.8.2.3](#)). URSO training SHALL be accomplished prior to appointment and annually thereafter while assigned.

6.8.3.1.1 Military personnel SHALL be a qualified NDI 2A772. **Civilian personnel** SHALL be a certified Level 2 or 3 in Radiography Testing IAW Appendix A or NAS 410 as applicable. Exception: Air Force Civil Service Technical School Instructors.

6.8.3.1.2 URSO training SHALL be accomplished prior to appointment and annually thereafter while assigned.

NOTE

URSO training is provided by the AF NDI Office, and is available on the AF NDI SharePoint at "<https://usaf.dps.mil/teams/22399/SitePages/Home.aspx#>".

6.8.3.2 Industrial Radiographer Training.

6.8.3.2.1 Initial Training. All industrial radiographers SHALL complete an approved course of instruction in the use of industrial X-ray equipment, which includes radiation hazards control, and demonstrate an understanding of acceptable practice. As a minimum, each radiographer SHALL be instructed in those portions of the following subjects, which applies to industrial radiographic operations and demonstrate understanding thereof:

- a. Fundamentals of Radiation Safety
 - (1) Characteristics of X-ray and Gamma Radiation.
 - (a) Electromagnetic Spectrum.
 - (b) Properties of X-ray and Gamma Radiation.
 - (2) Interaction of Radiation with Matter.
 - (a) Ionization.
 - (b) Photoelectric Effect.
 - (c) Compton Effect.
 - (d) Pair Production.
 - (3) Attenuation of Radiation.
 - (a) Exponential Function.

- (b) Half-Value Layer (HVL) and Tenth-Value Layer (TVL).
- (c) Filtration.
- (d) Shielding.
- (4) Inverse Square Law.
- (5) Radiation Scattering.
 - (a) Secondary.
 - (b) Sky Shine.
- (6) Units of Radiation Measurement.
 - (a) Roentgen.
 - (b) Radiation Absorbed Dose (rad), Roentgen Equivalent Man (rem).
 - (c) Gray (Gy), 1 Gy = 100 rad; Sievert (Sv), 1 Sv = 100 rem.
 - (d) Exposure Rate and Dose Rate.
 - (e) Curie, Becquerel; 1 Curie (Ci) = 3.7×10^{10} Becquerel (Bq).
- b. Hazards of Exposure to Radiation.
 - (1) Naturally Occurring Radiation.
 - (2) Biological Effects.
 - (a) Mechanism of Tissue Damage.
 - (b) Variables Influencing Radiation Doses.
 - (c) Somatic and Genetic Effects.
 - (d) Occupational Dose Limits.
 - (e) Non-Occupational/Public Exposure Limits.
- c. Radiation Exposure Records.
 - (1) Prior Exposure History.
 - (2) Reports of Radiation Exposures.
- d. Radiation Measurement.
 - (1) Principles of Radiation Measurement.
 - (a) Energy Dependence.
 - (b) Response Time.

- (c) Ionization Chamber Instruments.
- (d) Geiger-Mueller Instruments.
- (2) Dosimetry.
 - (a) Use of OSL Dosimeters, TLD's, or Film Badges.
 - (b) Pocket Ion Chambers (Pocket Dosimeters).
 - (c) Electronic Dosimeters (Indications and Alarms).
- (3) Survey Meters.
 - (a) Meter Differences.
 - (b) Meter Operation and Calibration.
 - (c) Meter Capabilities and Limitations.
 - (d) Survey Techniques.
- e. Radiation Protection.
 - (1) Control of Radiation Dose.
 - (a) Dose Rate Factors (X-ray and/or Gamma Radiation).
 - (b) Time, distance, and shielding.
 - (c) ALARA principle.
 - (2) Safety Equipment for Unshielded Operations.
 - (3) Safety Equipment for Shielded Operations.
- f. Practical Application Requirements.
 - (1) Choosing Radiographic Equipment to Use.
 - (2) Radiation Exposure in Shielded Operations.
 - (a) Accidental Exposure.
 - (b) Beam Orientation.
 - (c) Location of Operating Controls.
 - (d) Checkout of Safety Devices.
 - (3) Radiation Exposure in Unshielded Operations.
 - (a) High (and very high) Radiation Areas.
 - (b) Placement of Barriers.

- (c) Measurement of Exposure Rates.
- g. Inspection and Maintenance Performed by Radiographers.
 - (1) Interlocks.
 - (2) Warning Devices.
 - (3) Radiography Equipment/Facilities.
- h. Emergency Procedures.
- i. Case Histories of Radiography Accidents.
- j. Regulations.
 - (1) Applicable Military Service.
 - (2) Federal.
 - (3) State.
 - (4) Local.

6.8.3.2.2 **Radiation Safety Training.** AFMAN 48-148 specifies radiation safety training requirements. Each radiographer SHALL receive training initially, annually or whenever there is a change in equipment, operating procedures, radiation protection surveys or regulations, technical data or instructions (e.g. supplemental training). Radiation safety training SHALL be documented and include the items identified below.

NOTE

A Unit specific training plan shall be developed by Unit Radiation Safety Officer (URSO). The training program shall be reviewed and revised as necessary to reflect changes in practices for the workplace.

6.8.3.2.2.1 **Initial/Annual Training.**

- a. Deficiencies identified during periodic quality audits of the radiation protection program (e.g. Annual Radiation Assessment performed by Bioenvironmental Engineering) and unit training inspections.
- b. Review of accidents and unusual events.
- c. Review of dosimetry results (emphasizing dose reduction and ALARA).
- d. Review of basic radiation safety principles, operating procedures, radiation protection (scatter) surveys, emergency procedure, new safety regulations and other pertinent information.
- e. Review use of instruments (e.g. survey meters), equipment (e.g. X-ray generators) and personal dosimetry (e.g. OSL's, EPD's, pocket ion chamber dosimeters, etc.) to measure radiation rates or dose rates, identify sources of radiation emission, and monitor individual dose rates.
- f. Review AFTO Form use and record keeping for applicable forms used.

NOTE

Supplemental radiation safety training only needs to be conducted on items which have changed.

6.8.3.2.2.2 As Low As Reasonably Achievable (ALARA) Training. ALARA training is provided by Installation Radiation Safety Officer (IRSO) initially and annually thereafter. Requirements in AFMAN 48-148 SHALL be adhered to.

6.8.3.2.2.3 Record Keeping. Training programs presented, course curricula, and attendance shall be maintained for a period of one (1) year. Radiation safety training SHALL be annotated on the AF Form 55, or approved equivalent documentation method.

6.8.4 Radiation Protection.

6.8.4.1 As Low As Reasonably Achievable (ALARA). All exposures SHALL be kept "As Low As Reasonably Achievable." Exposure to radiation, even at very low dose rates, is permissible only when the benefit derived from such exposure exceeds the risk incurred. Each individual SHALL strive at all times to maintain all radiation exposures "As Low As Reasonably Achievable." Individuals SHALL NOT ever knowingly expose themselves, or cause others to be unnecessarily exposed to radiation.

6.8.4.2 Radiation Dose Limits.

6.8.4.2.1 Occupational Dose Limits.

6.8.4.2.1.1 Dose Limits for Occupationally Exposed Adults.

- a. An annual limit, which is the more limiting of:
 - (1) The total effective dose equivalent (TEDE) of 5 rem (50 mSv); or
 - (2) The sum of the deep dose equivalent from external sources and the committed dose equivalent to any individual organ or tissue, other than the lens of the eye, of 50 rem (500 mSv).
- b. The annual limits to the lens of the eye, to the skin, and to the extremities, which include:
 - (1) An eye-lens dose equivalent of 15 rem (150 mSv); and
 - (2) Shallow-dose equivalent to the skin or to any extremity of 50 rem (500 mSv).

6.8.4.2.1.2 Dose Limit for Minors. The annual occupational dose limits for minors (less than 18-years of age) are 10% of the annual occupational dose limits specified for adults.

6.8.4.2.1.3 Dose Limits for Pregnant Females (Embryo/Fetus). The radiation dose to the embryo/fetus of an occupationally exposed pregnant female SHALL NOT exceed 0.5 rem (5 mSv) for the entire pregnancy. Additionally, efforts SHOULD be made to maintain the exposures ALARA and relatively uniform, that is, free of substantial dose rate variations above monthly exposure rates. Refer to DAFMAN 48-125 for details.

6.8.4.2.2 Dose Limits for Individual Members of the Public. The total effective dose equivalent to members of the public SHALL NOT exceed 100 mrem (1 mSv) in a year, above background, from all radiation sources under control of the installation activity commander. Additionally, the dose in any unrestricted area from external radiation sources such as industrial X-rays SHALL NOT exceed 2 mrem (0.02 mSv) in any 1 hour.

6.8.4.2.3 Multiple Sources of Radiation.

CAUTION

Occupationally exposed personnel SHALL NOT wear their dosimetry devices while undergoing medical or dental X-ray procedures.

When any individual is likely to be exposed to radiation from more than one source simultaneously, or at different times, the protection associated with each source SHALL be increased so the total dose received by any one person from all sources

SHALL NOT exceed applicable exposure limits. Additionally, the TEDE limits, the sum of external and internal radiation exposure, requires special consideration be given to ensure the combination of internal and external exposure does not exceed limits.

6.8.4.2.4 Medical, Dental Diagnostic, or Therapeutic, and Naturally Occurring Radiation. Radiation exposures resulting from necessary medical, dental diagnostic, or therapeutic radiation procedures SHALL NOT be included in the determination of the radiation exposure status of the individual concerned. Similarly, exposures resulting from naturally occurring sources or from sources in consumer products, SHALL NOT be included in determining an individual's dose.

6.8.4.3 Personnel Radiation Monitoring Requirements.

NOTE

A monthly wearing period SHALL be implemented for optically stimulated luminescence (OSL) dosimeters issued to minors and to pregnant women. Criteria requiring individual dosimetry are defined in: Title 10, Code of Federal Regulation, Parts 20 and 34; and DAFMAN 48-125. See [Paragraph 6.3.9.1](#) for more detailed information regarding dosimeters.

6.8.4.3.1 Criteria. Use of personnel monitoring devices is mandatory for each individual who MAY be exposed to ionizing radiation during the normal course of their duties or occupation according to the following criteria.

6.8.4.3.1.1 OSL dosimeters are the primary dosimetry device as the legal record of radiation exposure in the Air Force. For more information, see [Paragraph 6.3.9.1.1](#).

6.8.4.3.1.2 Occupationally exposed adults who may reasonably be expected to receive an annual dose in excess of 100 mrem (1 mSv).

6.8.4.3.1.3 Occupationally exposed adults entering any high or very high radiation area (regardless of the anticipated magnitude of exposure).

6.8.4.3.1.4 Declared pregnant women, are to be monitored for the entire period of pregnancy IAW DAFMAN 48-125.

6.8.4.3.1.5 All minors who may reasonably be expected to receive an annual radiation dose in excess of 50 mrem (.5 mSv) total effective dose equivalent (TEDE) to the whole body.

6.8.4.3.1.6 Other individuals as necessary for the effective management of the ALARA program, such as radiation safety monitors supporting unshielded radiography operations who do not otherwise require dosimetry devices, will be provided with dosimetry devices to include OSL dosimeters if their radiation dose would reasonably be expected to exceed the general public exposure limit of 100 mrem (1 mSv) TEDE per year or 2 mrem in one hour, above background.

6.8.4.3.1.7 Individuals not meeting any of the criteria contained herein should not be enrolled in, or be needlessly continued in the dosimetry program except on a case-by-case basis. If in doubt, IRSOs SHOULD enroll individuals in the dosimetry program for a limited duration, and base continued use of dosimetry on actual exposures received.

6.8.4.3.2 Wear of Whole-Body Dosimeters. Dosimeters (OSL, TLD, film badges) used to provide a permanent record of the cumulative exposure to the whole body as well as instant readout style dosimeters (EPD, pocket ion chamber) SHALL be worn on the trunk (below the shoulders and above the hips) outside of clothing, on the portion or area of the body nearest the radiation source. The dosimeter window/sensor SHALL face out from the body.

6.8.4.3.3 Wearing Additional Dosimeters. If radiation exposure to the eyes, extremities, or skin is likely to be significantly different from whole body exposure, additional dosimeters (collar, wrist, ring, etc.) SHALL be worn to document the actual exposure received by these areas. (Note: If eye protection providing at least 700 milligram per square centimeter thickness is used, the IRSO SHALL annotate this fact on the dosimetry issue listing beside the individual's name so the correct eye exposure can be noted.)

6.8.4.3.4 Storage of Monitoring Devices. All dosimeters (OSL's, EPD's, etc.) SHALL be centrally stored, located in a low background radiation area, in an environment free from excessive temperature and humidity. The dosimeters SHALL be returned to their dedicated storage location at the end of each work period.

6.8.4.4 Emergency Situations and Suspected Exposures Above Limits.

6.8.4.4.1 Emergency Situations. An exposure above occupational limits shall be suspected, and an emergency situation shall be considered to exist, when:

- a. An Electronic Personal Dosimeter (EPD) registers 500 mrem (5 mSv) or more (10 CFR 34.47) or any individuals' dosimeter exceeds maximum scale.
- b. The radiography supervisor, regardless of dosimeter readings, believes an overexposure has occurred, either to another radiographer or any person(s) not directly involved in the radiographic operation.

NOTE

Dosimeters determined to exceed maximum scale reading, or drift, prior to the first actual X-ray production of the shift, SHALL be considered defective. These dosimeters SHALL be withdrawn from service and turned into the servicing TMDE or PMEL calibration facility for evaluation.

6.8.4.4.2 Actions for Emergency Situations and Suspected Exposures Above Limits. If an exposure above occupational limits is suspected, an emergency situation SHALL be considered to exist. A locally developed emergency procedure SHALL be utilized, this procedure must be a standalone document and be easily located. The emergency procedure SHALL describe the actions required to be followed in the event of a mishap or emergency and SHALL specify, but not be limited to the following:

- a. Immediately cease all radiography operations and report the incident to the Immediate Supervisor and the following points of contact:
 - (1) NDI Laboratory Supervisor
 - (2) Unit Radiation Safety Officer (URSO)
 - (3) Installation Radiation Safety Officer (IRSO) or Bioenvironmental Engineering Section
 - (4) Unit Safety Officer/NCO
- b. Obtain the name, social security number, and organization of all personnel suspected of overexposure.
- c. Identify where to take the individual for treatment/observation, including the physical address of the facility.
- d. Initiate AF Form 190, *Occupation Illness/Injury Investigation* with Public Health.
- e. Notify the IRSO or Bioenvironmental Engineering Services of the suspected overexposure. Prepare to turn in the affected individual's OSL dosimeter and the control OSL (if applicable) for immediate processing, as directed. The occupational health physician in consultation with the IRSO, will determine the need for medical treatment.

NOTE

In those instances where the Installation Bioenvironmental Engineering Section cannot be notified, or is not locally available, the control OSL (if applicable) and the OSL dosimeter of the suspected overexposed individual SHOULD be sent via AIR MAIL; from overseas or FIRST CLASS from CONUS to: USAFSAM/OEA, 2510 Fifth Street, Area-B, Bldg. 840, Wright-Patterson AFB, OH 45433, DSN 798-3764.

- f. Read and record EPD/pocket ion dosimeters using the AFTO Form 115 (see [Paragraph 6.8.7.2.1](#)).
- g. Determine and record exact position and duration of exposure.

- h. Update the AFTO Form 125, Industrial Utilization Log as needed (see 6.8.7.2.2). Make sure the detailed sketch of the area includes the positions of personnel suspected of being overexposed and is documented using the AFTO Form 125A (6.8.7.2.3). Record all other pertinent data about the incident (X-ray apparatus position, kV, mA, and direction of primary beam).
- i. Obtain a signed statement from the exposed individual(s) of actions resulting in (or contributing to) the exposure.
- j. After completion of the above phase of the investigation and in the case of non-monitored personnel being exposed, the following procedure can be used by the IRSO or radiographers to quantify personnel exposure after the AF Form 190 is initiated:
 - (1) Re-establish the exact position(s) of all objects at the time of the accident.
 - (2) Place suitable dosimetry devices (e.g. EPD's/pocket ion dosimeters) at the position of the exposed individuals.

WARNING

Survey meters SHALL NOT be used, unless they have an integrate mode, or remote cameras are available to observe the instruments, since personnel using them will be unnecessarily exposed to radiation.

- (3) Expose the dosimeters, operating the X-ray apparatus at the same technique (kV, mA, beam orientation) as occurred during the incident, with the time of the exposure equal to the time personnel indicated they were present in the area or enclosure.

NOTE

If personnel were moving within the enclosure during the accident exposure, the dosimeters SHALL be placed at the position closest to the X-ray apparatus and at various points of travel.

- k. A complete report of the incident SHALL be prepared by the URSO and NDI Laboratory Supervisor (if not the URSO), with signed statements from all operators and personnel exposed indicating their concurrence with the report. A copy of this report SHALL be provided to the IRSO for review and filing in the industrial workplace case file. Additionally, copies will be forwarded to Air Force NDI Office, AFLCMC/EZPT-NDIO, aflcmc-ezpt-ndio@us.af.mil; DSN 339-4931, and to USAFSAM/OEA, 2510 Fifth Street, Area-B, Bldg. 840, Wright- Patterson AFB, OH 45433, DSN: 798-3764.
- l. Assure a new control badge is obtained, and designated as a replacement for the control badge submitted for analysis.

6.8.4.4.3 Administrative Assessment of Dose. If a dosimeter is lost, damaged, or if the occupationally-exposed individual's TEDE or CEDE cannot otherwise be determined, the IRSO SHALL determine and assign an administrative dose pursuant with AFMAN 48-148 and DAFMAN 48-125, and report the assigned dose to USAFSAM/OEA for inclusion in the individual's permanent dosimetry file.

6.8.4.5 Radiation Protection Surveys.

NOTE

Radiation Protection Surveys (Scatter Surveys) of all Shielded and Unshielded X-ray installations SHALL be performed by a fully qualified Health Physicist, Bioenvironmental Engineer, Nuclear Medicine Science Officer, and/or qualified Radiological Health Technician before the installation is placed into routine operation. A survey SHALL be re-accomplished whenever equipment (e.g. type of tubehead, interlock, etc.), or administrative controls (e.g. building modifications, locations of monitors, etc.) have changed.

6.8.4.5.1 Definition. As used in this section, radiation protection survey means an evaluation of potential radiation hazards associated with the use of industrial X-ray equipment, under specified conditions, when used in shielded and/or unshielded installations. When appropriate, such evaluation includes inspection of equipment, examination of its location with reference to controlled and uncontrolled areas in the immediate environment, and measurements of exposure levels.

6.8.4.5.2 Consultant Assistance. Consultant services of qualified health physicists are available to assist IRSOs. See [Paragraph 6.8.2.1](#). (a).

6.8.4.5.3 Local IRSO Involvement. An assessment of shielded installations SHALL be made by, or under the direction of the local IRSO initially before use. Assessments shall also be used before changes are made in shielding, operation, workload, equipment ratings or occupancy of adjacent areas when these changes, in the opinion of the IRSO, can adversely affect radiation protection. If supplementary shielding is installed as a result of the radiation protection survey or re-evaluation, another survey SHALL be made to confirm the adequacy of the shielding after the modification.

6.8.4.5.4 Survey Conditions. In evaluating the results of the survey, consideration SHALL be given to actual operating conditions, including workload, use factor, occupancy factor, and attenuation of the useful beam provided by objects permanently in the path of the useful beam.

6.8.4.5.5 Identification of Radiation Hazards. Radiation hazards found in the course of a survey of any type installation SHALL be eliminated before the installation is used routinely. If the design and/or approved use of a shielded installation depend upon restrictions on the use factor of any primary barrier, it must be verified these restrictions are actually observed.

6.8.4.5.6 Inspection of Safety and Warning Devices.

WARNING

All interlock, "ON/OFF" beam control mechanisms, safety and warning devices, remote monitoring systems, etc., SHALL be inspected for proper operation PRIOR to use for both shielded and unshielded X-ray operations. For units who do not use their shielded facilities on a regular basis, interlocks SHALL be subjected to detailed operational testing at intervals not to exceed six-months, see TO 33B-1-2, WP 106 00. Any malfunctioning devices SHALL be appropriately serviced prior to use and reinspected to verify proper operation.

6.8.4.5.7 Compliance in Uncontrolled Areas. Whenever, in the opinion of the RSO or the radiographer, there is a reasonable probability a person in an uncontrolled area, adjacent to any type of radiation installation, may receive more than 2 mrem (0.02 mSv) in any one hour, or 100 mrem (1 mSv) in any calendar year, above background, then one or more of the following courses of action as determined by the RSO SHALL be taken to ensure no person will receive exposure in excess of the basic radiation protection standard:

- a. Use personnel or area monitoring devices to estimate the exposure received by occupants of the area, applying appropriate occupancy factors for each assessed location (coordinate with USAFSAM/OEA, 2510 Fifth Street, Area- B, Bldg. 840, Wright-Patterson AFB, OH 45433, DSN: 798-3764).
- b. Add supplementary shielding to the protective barriers to ensure conformity with protective barrier recommendations contained in this publication.
- c. Restrict use of the equipment (workload (on-time), kV, or use factor).
- d. Restrict occupancy of the area.

6.8.4.5.8 Shielded Installation. A radiation protection survey SHALL be made before the installation is placed into routine operation. The installation SHALL be inspected to verify adequacy of shielding, radiation protective devices and operational procedures.

WARNING

- The use of engineering design controls, such as additional shielding, SHALL take precedence over operational (administrative) controls.
- Surveys SHALL be performed while the X-ray apparatus is operating at the maximum kilovoltage and milliamperage required for the Tube Warm-up Procedure.

6.8.4.5.8.1 When surveying shielded installations, the radiation exposure measurements SHALL be made in all adjacent areas accessible to personnel. The measurements SHALL be made under facility design conditions of operation that will result in the greatest exposure at the point of interest. X-ray apparatus SHALL be operated at the maximum kilovoltage (kV) specified in the design criteria for the facility and at its maximum milliamperage (mA) for continuous operation at that voltage. High energy equipment (e.g., linear accelerators, betatrons, etc.) SHOULD be operated at maximum output.

6.8.4.5.9 Unshielded Installations.

CAUTION

The Tube Warm-Up Procedure SHALL only be performed at a location or facility that has been surveyed at the X-ray apparatus maximum kilovoltage and milliamperage.

A radiation protection survey SHALL be conducted before the installation is placed into operation. Additionally, unshielded installations SHALL be actively surveyed by radiographers during each subsequent operation. Initial surveys SHALL include radiation exposure measurements to establish, or verify safe operating conditions as established by the applicable standard operating procedures.

6.8.4.5.9.1 Pulsed X-ray.

CAUTION

Electronic Personal Dosimeters (EPDs) DO NOT accurately measure radiation in short-pulsed (60-nanosecond) X-ray environments.

- a. For designation of all areas, where pulsed X-ray operations will be performed, a detailed radiation protection survey SHALL be conducted by a fully qualified Health Physicist, Bioenvironmental Engineer, Nuclear Medicine Science Officer or qualified radiological health technician.
- b. The RSO or their representative SHALL evaluate each area to ensure that the restricted area is setup IAW [Paragraph 6.8.6.2.3.2.1.](#)
- c. Additionally, all workers, working in close proximity to pulsed X-ray operations SHALL be briefed on safety procedures and SHALL NOT enter the established restricted area.

6.8.4.5.10 Report of Radiation Protection Survey.

CAUTION

Existing installations SHALL NOT be assumed to conform to the provisions of this publication, unless a valid radiation protection survey has been made by a qualified expert and a report has been placed on file at the installation.

6.8.4.5.10.1 Distribution and Retention of Radiation Protection Surveys.

6.8.4.5.10.1.1 Survey Distribution. The written survey (with attachments) SHALL be forwarded by the agency conducting the survey (e.g. Bioenvironmental Engineering Section, USAFSAM/OEC etc.) to the organization surveyed. The URSO SHALL review the survey for compliance (see 6.8.4.6.10.2). Concerns with the survey report SHALL be brought forward to the surveying agency immediately and resolved in a timely manner. If the survey is performed by an organization other than USAFSAM/OEC, and concerns with survey compliance are not resolved, a copy of the survey SHALL be submitted to USAFSAM/OEC, 2510 Fifth Street, Area-B, Bldg. 840, Wright-Patterson AFB, OH 45433 or usafsam.oehrworkflow@us.af.mil and the AF NDI Office, 5295 Warehouse Rd., Bldg. 2211, Tinker AFB, OK 73145 or aflcmc-ezpt-ndio@us.af.mil for review. The reviewed report will be returned with recommendations for any corrective measures and will indicate if an additional survey is necessary after correction have been made.

6.8.4.5.10.1.2 Survey Retention Requirements. Reports of all radiation protection surveys SHALL be retained by the local Bioenvironmental Engineering Services and the Laboratory supervisor together, with a record of the actions taken, with respect to the recommendations the survey contains.

6.8.4.5.10.2 Survey Contents. Radiation protection survey SHALL be a standalone document.

NOTE

A Survey Contents Checklist is available on the AF NDI SharePoint "<https://usaf.dps.mil/teams/22399/SitePages/Home.aspx#>" and should be used when conducting the radiation protection (scatter) survey to ensure all requirements are met.

6.8.4.5.10.2.1 Identification of the radiation source(s), and location of each by suitable means, e.g., serial number, room number, and building number or name.

6.8.4.5.10.2.2 The radiation output (kV/mA) of the radiographic device (the radiation output of the device will be the level specified by the manufacturer or obtained from remote survey readings. Unnecessary radiation exposure SHALL NOT be incurred to obtain such information.)

NOTE

The maximum dose rate from the aperture of the Spellman/Lorad LPX-160 Industrial X-ray Unit at 160 kV is 2.61 grays (261 rads) per minute at 0.5 meters, thus the maximum dose at 1 meter received in one minute would be 0.65 grays (65 rads). As such, "Very High Radiation" areas can exist for this and comparable radiation sources. The X-ray source dose rate measured at 1 meter from the aperture of the tube will be used to determine the applicable radiation area IAW 10 CFR 20.1003 and appropriate signage IAW 10 CFR 20.1902.

6.8.4.5.10.2.2.1 X-ray source -- in roentgens per minute (R/min), at one-meter, at maximum kV and mA, (under shielding conditions indicative of normal operation). The potential and current at which the X-ray tube was operated during the test will be specified if less than the system operating limits.

6.8.4.5.10.2.3 Identification of the radiation survey instruments used, including its serial number and the date calibrated.

6.8.4.5.10.2.4 The location of the source, and the orientation of the useful beam in relation to each exposure measurement.

6.8.4.5.10.2.5 Exposure rates in all adjacent areas accessible to personnel. The location of exposure rate measurements SHALL be in accordance with applicable criteria and SHALL be suitably identified by drawings.

6.8.4.5.10.2.6 An assessment of whether the measured exposure rates will result in uncontrolled areas having a total exposure of greater than 2 mrem (0.02 mSv) in any one - hour, or greater than 100 mrem (1 mSv) in a year, above background, using the expected workloads, use factors and occupancy factors for the facility. The occupancy factor SHALL NOT be used to determine compliance with the 2 mrem (0.02 mSv) in any one-hour limit.

6.8.4.5.10.2.7 A description of the existing safety, mechanical, and electrical limiting devices that restrict the orientation of the useful beam (e.g., Collimated Sources-tube head 40 deg cone with lead shield), position of the source, or otherwise supports radiation safety protection efforts (e.g., Make and model of X-ray interlock system, additional shielding added, etc.).

6.8.4.5.10.2.8 A statement indicating the appropriate classification of the installation ([Paragraph 6.8.6](#)) and the radiological design criteria for which it was designed, if available.

6.8.4.5.10.2.9 A statement of what controls are required, if exposures are estimated to exceed 100 mR in a year or 2 mR in any one-hour in uncontrolled areas. Engineering controls (e.g., additional shielding, physical barriers, etc.), SHALL always take precedence over administrative controls (e.g., restrictions on workload).

6.8.4.5.10.2.10 Identification of the individual conducting the survey, to include parent organization and the date the survey was accomplished.

6.8.4.5.10.2.11 A statement of facility compliance/non-compliance with the following directives.

- a. If an installation does not comply with this publication, it SHALL be stated what action must be taken to ensure compliance.
- b. If a resurvey is required, it SHALL be so stated. The time frame as to when the resurvey is required, and whether or not operations are permitted prior to the resurvey SHALL be included.

6.8.4.6 Annual Radiation Assessment.

NOTE

While a radiation assessment must be conducted annually, a *radiation protection survey (scatter survey)* may not be required as often. See [Paragraph 6.8.4.5](#) for information on when to perform radiation protection surveys.

6.8.4.6.1 A radiation assessment SHALL be conducted by the IRSO or his/her representative, as an integral part of the annual quality assurance audit of the Radiation Protection Program. Assessments SHALL verify the adequacy of operating procedures, the presence and proper use of radiation warning signs and signals, and other necessary equipment. Annual ALARA training and assessment of worker dose to radiation SHALL also be verified and conducted IAW AFMAN 48-148 and DAFMAN 48-125. A formal report SHALL be generated to document the assessment findings and revalidate operating procedures, emergency procedures, and radiation protection survey results and restrictions.

6.8.4.6.1.1 The Annual Radiation Assessment SHALL document the following:

NOTE

An Annual Radiation Assessment Checklist is available on the AF NDI SharePoint "<https://usaf.dps.mil/teams/22399/SitePages/Home.aspx#>" and should be used when conducting the assessment to ensure all components are reviewed. An equivalent or locally developed checklist may be used IF it covers all requirements in 6.8.4.6.1 & 6.8.4.6.1.1.

- a. Review all radiation exposure records (e.g. dosimetry data) and radiation protection surveys.
- b. Evaluate the content and effectiveness of the ALARA training program.
- c. Review existing facility designs for compliance with this document and other applicable instructions.
- d. Verify proper location and operation of interlocks, warning signs, and beacons/lights.
- e. Evaluate new X-ray equipment (if applicable).
- f. Assess impact of new facility modifications (if applicable).
- g. Verify all required forms (e.g. AFTO Forms) are correctly completed.
- h. Generate a formal report covering each program component reviewed (identifying compliance or non-compliance), along with assessment findings and deliver to the Unit Commander, and NDI Laboratory Supervisor/URSO.

6.8.4.7 Communication Requirements for Radiographic Operations. Based on the facility, additional communication requirement MAY need to be outlined in the operating procedure. If the RIC is unable to monitor all radiographers visually during exposure or the entire perimeter of the barrier, an adequate means of communication SHALL be specified. Adequate means of communication MAY include, two-way radios, whistles, electronic/propellant-activated noise alarms or ultrasonic infrared intrusion barriers, but need not be limited to these methods.

6.8.5 Industrial Radiographic Operations.

6.8.5.1 System Types. There is only one type of radiographic system in use by the Air Force. That is a machine generated X-ray device. Gamma source systems are no longer in use in the Air Force.

6.8.6 Industrial Radiographic Installation Classifications.

NOTE

The Air Force classifies two types of installations shielded and unshielded. A shielded installation is described as any enclosed radiographic facility designed to limit exposures on the outside of the facility. An unshielded installation is an area where fixed shielding cannot be used (e.g., flight line, open hangars make-shift buildings, etc.).

6.8.6.1 Shielded Installations. The Air Force describes a shielded installation as any enclosed radiographic facility designed to limit exposures on the outside of the facility to less than 2 mrem (0.02 mSv) in any one-hour and less than 100 mrem (1 mSv) in a year, above background. The shielding design incorporates the energy of the X-ray source to be used, as well as the expected workload, use factors, and occupancy factors of installation. Occupancy factor SHALL be considered only for the 100 mrem (1 mSv) in a year limit.

6.8.6.1.1 Requirements for Shielded Facilities. An installation SHALL be classified as "shielded" when it conforms to all of the following mandatory requirements: Each of the following SHALL be provided (except where specifically noted) without regard to the size and/or configuration of the enclosure.

WARNING

Buildings NOT equipped with ceiling shielding SHALL consider that maintenance personnel may place a ladder at any location along the roof of the building or have blind access from another location within the building. "Warning sign(s), rope barriers, and when possible, access locking mechanism(s)" SHALL be used at all access points to warn personnel and notify them to check in with the NDI Laboratory Supervisor to ensure X-ray operations are not taking place while personnel are in the area.

6.8.6.1.1.1 Shielding requirements will limit radiation exposure as identified in [Paragraph 6.8.8.4.1](#).

6.8.6.1.1.2 No person, either within the controlled area or in the surrounding area or immediate area of a "Shielded" installation, SHALL receive radiation exposures exceeding the total effective dose equivalent limits for members of the public.

6.8.6.1.1.3 The radiation source and all objects to be exposed are within a permanent enclosure, and no person is permitted to remain within during irradiation.

6.8.6.1.1.4 Each entrance used for personnel access to the enclosure/very high or high-radiation area as defined in 10 CFR 20.1003, SHALL have visible warning signals. These signals include: warning signs and beacons, the latter is tied to and discussed under "interlock system."

NOTE

The maximum dose rate from the aperture of the Spellman/Lorad LPX-160 Industrial X-ray Unit at 160 kV is 2.61 grays (261 rads) per minute at 0.5 meters, thus the maximum dose at 1 meter received in one minute would be 0.65 grays (65 rads). As such, "Very High Radiation" areas can exist for this and comparable radiation sources. The X-ray source dose rate measured at 1 meter from the aperture of the tube will be used to determine the applicable radiation area IAW 10 CFR 20.1003 and appropriate signage IAW 10 CFR 20.1902.

- a. Warning Signs.
- (1) IAW 10 CFR 20.1902, the interior of the exposure room SHALL be posted with "Caution, High Radiation Area" or "Danger, High Radiation Area" or "Grave Danger, Very High Radiation Area" signs so they are visible from any location within the room. The interior of a cabinet installation SHALL be posted with an identical sign that SHALL be visible with the access door open.
 - (2) The entrance to the exposure room, or cabinet for cabinet type installations, housing X-ray equipment SHALL be posted with "Caution, Radiation Area" marking signs.
 - (3) A label or sign "Caution, Produces X-rays when energized" (or equivalent) SHALL be affixed to the X-ray tube head.
- b. Interlock System.The visible and audible warning beacons/signals SHALL be tied to an interlock system. The interlock system SHALL be placed on each door to interrupt power to the control box/tube head, stopping the irradiation process, when unauthorized access is attempted. In the event of a warning beacon/signal malfunction (i.e. bulb burns out), the interlock SHALL terminate power to the X-ray tube. A time delay/interlock MAY be locally fabricated or purchased in order to meet this requirement. The wiring harnesses are similar to the harnesses used with X-ray Interlock Assembly. All time delay interlock systems installed SHALL be compatible with all X-ray units commonly available. The pre-start switch, pre-exposure alarm, and warning beacons SHALL all be tied to the interlock system and are discussed further in the following paragraphs.
- c. Pre-Start Switch.The switch SHALL be located inside the enclosure, so if irradiation is interrupted by opening a safety interlock, resumption of operation can only be accomplished after the pre-start switch has been reactivated. This ensures a thorough search for personnel working within the enclosure is performed prior to activating the source. A pre-start switch SHALL NOT be required if:
- (1) The tube head is de-energized when an interlock is tripped.
 - (2) The X-ray tube cannot be re-energized by merely closing the interlock. To re-energize the X-ray tube, the entire time delay interlock system must be re-initiated at the X-ray machine control panel.
- d. Pre-exposure Audible Alarm.A pre-exposure audible alarm, SHALL be used within the enclosure and must be actuated at least 20-seconds before irradiation starts. Audible alarms SHALL cease when radiation is started, but the visible warning signal (see [Paragraph 6.8.6.1.1.4, Step e](#)) SHALL remain actuated during irradiation. The audible signal SHALL NOT be less than 75 decibels at every location where an individual may be present whose immediate, rapid, and complete evacuation is essential. Audible alarms are not required if the enclosure is so small it cannot be entered by an individual. An example of such an enclosure is a cabinet X-ray system that has a small opening into which the part to be radiographed is placed, but into which an individual could not gain entry without difficulty.

NOTE

The interlock system with a rotating Amber light operating during the audible alarm and separate Red light operating during the radiation process is authorized for use in the shielded facility.

- e. Warning Beacons.Rotating or flashing strobe-type visible warning beacons SHALL be used at all entrances to the enclosure. These must be activated at least 20-seconds before irradiation starts (simultaneously with audible alarm). These beacons SHALL be located so they are visible to an individual entering, or already inside of the facility, and will be operational when X-rays are being produced. An adequate sign SHALL be clearly displayed near the lights to explain their function. Red warning beacons SHALL be located within the enclosure, and red beacons SHALL be used outside all entrances to the enclosure. Low intensity, flashing warning lights SHALL NOT be used unless special circumstances occur. The IRISO SHALL be the only approval authority for these special circumstances.
- f. Entrance/Exit.A suitable means of exit SHALL be provided so any person, who accidentally may be shut inside, can leave the enclosure without delay. This door SHALL be tied to the interlock, so if it is accidentally opened during exposure, it will automatically turn the exposure off.

- g. Emergency Shut-off Switch. Emergency shut-off switch(s) SHALL be provided within the facility, and labeled with a sign stating "EMERGENCY SHUT-OFF" in red letters on a white background. A sufficient number of signs and switches SHALL be placed where they are visible and readily activated from any portion of the interior of the shielded/protective installation. The emergency shut-off switch SHALL NOT be obstructed. The area directly in front of and two feet on either side of the emergency shut-off shall remain clear at all times. An emergency shut-off switch SHALL NOT be required if the enclosure is so small that it cannot be entered by an individual. An example of such an enclosure is a cabinet X-ray system.

6.8.6.1.1.5 The shielded facility SHALL NOT be used for excessive storage. All radiation warning signs and shut-off switches SHALL be at eye level (approximately 5 feet from ground), visible from all directions, with no obstructions. Excessive clutter may interfere with accurate survey measurements and cause an unsafe condition should an emergency shut-off and egress from the facility become necessary.

6.8.6.1.2 MANDATORY OPERATING PROCEDURES - Shielded Installation.

6.8.6.1.2.1 Operating Procedures. The operating procedure is mandatory and SHALL be adhered to. It SHALL describe the actions or steps necessary to safely conduct a shielded radiographic operation. The procedure SHALL be facility specific, clearly written and specify, but not be limited to the following:

NOTE

- The operating procedure SHALL be used as step by step guidance when performing radiographic operations. It SHALL be a standalone document. The facility SHALL be identified and the procedure tailored to the specific enclosure/setup.
 - Responsibilities for the Radiographer in Charge (RIC) ([Paragraph 6.8.2.4](#)), Radiation Safety Monitor(s) ([Paragraph 6.8.2.5](#)) and Radiation Safety Monitor Assistants, if applicable ([Paragraph 6.8.2.5.1](#)) SHALL be incorporated.
- a. A current radiation protection survey will be on file and used when performing radiographic operations.

NOTE

Prior to making an exposure, the enclosure SHALL be surveyed ([Paragraph 6.8.4.5](#)) to determine the adequacy of facility shielding.

- b. All personnel SHALL be trained and practice the ALARA (As Low As Reasonably Achievable) concept ([Paragraph 6.8.3.2.2](#) and [Paragraph 6.8.4.1](#)).
- c. All radiographers participating in radiographic operations SHALL correctly wear an assigned OSL dosimeter and properly calibrated EPD, with readings annotated on the AFTO Form 115 ([Paragraph 6.3.10.1](#) and [Paragraph 6.8.7.2.1](#)).
- d. Perform pre-operational checks of X-ray equipment in accordance with manufacturer's instructions or suitable technical data prior to use.
- e. The installation SHALL be inspected by radiographers prior to use to verify proper operation of audible and visible warning signals, interlock, emergency shut-off switches and other items that have a bearing on radiation protection ([Paragraph 6.8.6.1.1.4](#) and TO 33B-1-2, WP 106 00 for Interlock Operational Check). A general purpose or AFTO Form 135 signed off by the individual conducting the inspection SHALL be maintained ([Paragraph 6.8.7.2.4](#)). Any malfunctioning safety device SHALL be appropriately serviced/repaired prior to use and re-inspected to verify proper operation.
- f. Except when making verification of safety interlock operation or in emergencies, door interlocks SHALL NOT be used as a means of terminating the exposure. The exposure SHALL be terminated at the control panel.
- g. A thorough search for personnel working within the enclosure SHALL be conducted prior to activating the source.

WARNING

Buildings NOT equipped with ceiling shielding SHALL consider that maintenance personnel may place a ladder at any location along the roof of the building or have blind access from another location within the building.

Warning sign(s), rope barriers, and when possible, access locking mechanism(s) SHALL be used at all access points to warn personnel and notify them to check in with the NDI Laboratory Supervisor to ensure X-ray operations are not taking place while personnel are in the area.

- h. At least one operational, calibrated survey meter SHALL be available for immediate use by the radiographer during all radiographic operations. Documentation SHALL be completed on the AFTO Form 140 ([Paragraph 6.8.7.2.5](#)).
- i. Announce (vocalize) "X-RAY ON" and "X-RAY OFF" prior to and post radiographic exposures.
- j. Perform warm-up of X-ray generator (if applicable) and operate in accordance with manufactures instructions.

WARNING

Ensure the facility is surveyed for the maximum kilovoltage and miliamperage required for the Tube Warm-up Procedure.

- k. A qualified radiographer SHALL be present at the control panel during all radiographic exposures and will be the only person authorized to operate radiographic equipment.

NOTE

The RIC may only yield the controls when training NDI personnel. The RIC SHALL accompany the trainee during all aspects of the radiographic process and ensure strict compliance with technical order, radiation protection survey (scatter survey) and approved operating procedure.

- l. When a radiographic exposure has been completed, the safety-switch key SHALL be removed from the control panel. The RIC SHALL retain positive control of the safety-switch key at all times during radiographic operations, and the safety-switch key SHALL not be left unattended in the control panel between individual exposures.
- m. When entering the exposure room after deactivation of the radiation source, personnel SHALL use a calibrated survey meter to ensure the source has returned to its "off" position (to ensure X-rays are no longer being produced).
- n. All information required on the AFTO Form 125/125A SHALL be recorded by the RIC ([Paragraph 6.8.7.2.2](#) and [Paragraph 6.8.7.2.3](#)).
- o. If an exposure above occupation limits is suspected, begin emergency procedure ([Paragraph 6.8.4.4.2](#) and [Paragraph 6.8.7.1](#)).

WARNING

Bioenvironmental engineering will approve all laser pointers prior to use and personnel will be trained in accordance with AFI 48-139, Laser and optical Radiation Protection Program. The Lorad Class 3R Laser Pointer SHALL NOT be directed above the horizon near the flight line, as this may be dangerous to flight operations. The laser will have a warning affixed to it, and it SHALL only be in the on position when aligning film and off at all other times. The laser will be treated as a dangerous tool and SHALL not be pointed at any individual.

- p. In the case of multiple exposures in which the beam direction, intensity (kV, mA) or attenuating materials are significantly altered, the enclosure SHALL have a radiation protection survey for the setup.

6.8.6.2 **Unshielded Installations.** An installation SHALL be classified as “unshielded,” if due to operational requirements it cannot be provided with the inherent degree of protection specified for Air Force shielded installations. Such installations include fenced or “roped-off” areas located either in the open, or inside buildings such as hangar bays.

6.8.6.2.1 **Establishment of Restricted Area.** Radiographic operations in unshielded facilities require an initial evaluation of the exposure area to determine the bounds of the area to be restricted during exposure.

- a. A restricted area means: “any area to which access is controlled by the individual in charge of radiation protection for the purpose of protection of individuals from exposure to radiation.” This implies a restricted area is one that requires control of access, occupancy, and working conditions for radiation protection purposes.
- b. The dose limit in any unrestricted area from external radiation sources SHALL NOT exceed 2 mrem (0.02 mSv) in any one-hour. In addition, operations SHALL be conducted so radiation exposure to individual members of the public SHALL NOT exceed 100 mrem (1 mSv) in a year, above background. It SHALL be noted the definition does not limit the radiation exposure to a particular rate (such as 4 mR/hr), but permits higher exposure rates PROVIDING that the total quantity of radiation in any unrestricted area during any one-hour does not exceed 2 mrem (0.02 mSv) and during any calendar year considering occupancy factors, does not exceed 100 mrem (1 mSv) to any single individual. Occupancy factor SHOULD be considered for determining compliance with the annual limit.
- c. Special consideration SHALL be given to ensure restricted areas are of sufficient size to preclude adverse impact on adjacent operations. When in doubt, ensure qualified experts are consulted prior to initiation of operations.
- d. Summary data, comparing the measured exposure rate with the maximum allowable on-time (in minutes per hour) of the radiation source so the total dose in any one hour does not exceed 2 mrem is provided (see [Table 6-25](#)).

Table 6-25. Maximum Permissible Dose Rate Versus Hourly Duty Cycle

Measured Exposure Rate (mrem/hr)	Total Time X-ray is Operated During a One-Hour Period (minutes)
30	4
24	5
20	6
17	7
15	8
13	9
12	10
8	15
6	20
5	24
4	30
2	60

6.8.6.2.2 **Requirements for Unshielded Facilities.** Unshielded installations SHALL conform to all of the following requirements:

NOTE

High Radiation Area boundaries SHALL be calculated only. Surveys SHALL NOT be performed unless such surveys can be accomplished (using devices such as those, which integrate dose) without additional, unnecessary exposure to personnel.

6.8.6.2.2.1 Compliance with radiation dose limits applicable to the general public and to occasionally exposed individuals requires that access to areas in which radiation doses could exceed 2 mrem (0.02 mSv) in any one-hour or 100 mrem (1

mSv) in a year, above background, SHALL be restricted. "Radiation Area" postings SHALL be extended out from the X-ray tube such as to encompass such areas, or alternative arrangements made to restrict access to this area.

6.8.6.2.2.2 If the beam orientation or technique factors change between exposures, the radiation area boundaries SHALL be reestablished and the boundaries of radiation areas reverified.

6.8.6.2.2.3 Red, rotating, or flashing strobe-type visible warning beacons SHALL be used and positioned at the X-ray source (low-Intensity flashing warning lights SHALL NOT be used). The beacon positioned at the source SHALL be rotating/flashing ONLY when the source is energized.

NOTE

The interlock system with a rotating Amber light operating during the audible alarm and separate Red light operating during the radiation process is authorized for use in the unshielded installation.

6.8.6.2.2.4 An X-ray interlock SHALL be installed between the control unit and the rotating/flashing strobe-type "X-RAY ON" beacon. The interlock assembly enables electrical power to the "X-RAY ON" power circuits only after the rotating/flashing strobe type "X-RAY ON" warning beacon is attached. A pre-exposure audible alarm SHALL be used and must be actuated at least 20-seconds before irradiation starts (simultaneously with beacons). Interlock Bypass Plugs SHALL NOT be used.

6.8.6.2.2.5 Radiation protection surveys for unshielded locations SHALL be use as a guideline for setup instructions. Required manning for the radiographic operation SHALL be determined based on the radiation protection survey requirements. The radiation protection survey should provide recommendations for monitor placement, operating procedures SHALL outline monitor requirements for the specific facility or location ([Paragraph 6.8.6.2.2.7](#) and [Paragraph 6.8.6.2.3](#)). Monitor placement SHALL be documented on the AFTO Form 125A ([Paragraph 6.8.7.2.3](#)). Deviations from setup procedures or location and number of radiation safety monitors, or radiation safety monitor assistants SHALL be approved by the IRSO prior to X-ray operations. If the perimeter is of such a size or is so arranged that the operator cannot readily determine whether the radiation area is unoccupied, a sufficient number of radiation safety monitors and/or radiation monitor assistants SHALL be strategically located to provide adequate visual surveillance over the entire area. These personnel SHALL have in their possession an adequate and properly calibrated survey meter. The requirement for additional monitors MAY not be necessary if: the radiographic procedures are to be accomplished in a fenced-in, or in a locked area to which access is controlled by the RIC. In addition, there SHALL NOT be less than one radiation safety monitor.

6.8.6.2.2.6 The radiation source and equipment, essential to the use of the source, SHALL be made inaccessible to unauthorized use, tampering or removal while not in use. This SHALL be accomplished by such means as a locked enclosure.

6.8.6.2.2.7 To prevent radiation barrier penetration, two qualified radiographers, and as many safety monitor assistants as needed, should be used. If two qualified radiographers are not available, at least one qualified radiographer SHALL be used with as many radiation safety monitor assistants as required. Training for radiation safety monitor assistants SHALL be conducted (see [Paragraph 6.8.2.5.1.1](#)).

6.8.6.2.2.8 If the unshielded installation is in a remote area, and if entry into the enclosed area can be absolutely prevented during irradiation, the source and all objects exposed SHALL be within a conspicuously posted perimeter that limits the area in which the exposure can exceed 100 mR/hr (1 mSv/hr) in an hour provided:

- a. The perimeter is posted with a sufficient number of "Caution, Radiation Area" signs so as to be clearly visible from any direction of approach.
- b. The boundary of the restricted area can be determined where applicable.
- c. The requirements of this (see [Paragraph 6.8.6.2](#)) can be met.

6.8.6.2.2.9 Personnel SHALL NOT be exposed to more than the dose limits prescribed in [Paragraph 6.8.4.2](#).

6.8.6.2.3 MANDATORY OPERATING PROCEDURES - Unshielded Installation.

6.8.6.2.3.1 Operating Procedures. The operating procedure is mandatory and SHALL be adhered to. It SHALL describe the actions or steps necessary to safely conduct an unshielded radiographic operation. The procedure SHALL be facility/location specific, clearly written and specify, but not be limited to the following:

NOTE

- The operating procedure SHALL be used as step by step guidance when performing radiographic operations. It SHALL be a standalone document. The facility/location SHALL be identified and the procedure tailored to the unshielded facility/location and setup.
 - Responsibilities for the Radiographer in Charge (RIC) ([Paragraph 6.8.2.4](#)), Radiation Safety Monitor(s) ([Paragraph 6.8.2.5](#)) and Radiation Safety Monitor Assistants, if applicable ([Paragraph 6.8.2.5.1](#)) SHALL be incorporated.
- a. A current radiation protection survey will be on file and used when performing radiographic operations ([Paragraph 6.8.6.2.2.5](#)).

NOTE

Prior to making an exposure, the area SHALL be surveyed ([Paragraph 6.8.4.5](#)) to establish patterns of any radiation fields that could be present and to determine the adequacy of barrier placement.

- b. All personnel SHALL be trained and practice the ALARA (As Low As Reasonably Achievable) concept ([Paragraph 6.8.3.2.2](#) and [Paragraph 6.8.4.1](#)).
- c. All radiographers participating in radiographic operations SHALL correctly wear an assigned OSL dosimeter and properly calibrated EPD, with readings annotated on the AFTO Form 115 ([Paragraph 6.3.10.1](#) and [Paragraph 6.8.7.2.1](#)).

NOTE

EPDs do not accurately measure radiation in the pulsed radiation environment. For requirements specific to pulsed radiation see [Paragraph 6.8.4.5.9.1](#) and [Paragraph 6.8.6.2.3.2](#).

- d. Restricted area boundaries are established and reestablished as required by the radiation protection survey ([Paragraph 6.8.6.2.2.2](#)).

NOTE

Once the restricted area is identified, it SHALL be adequately posted to ensure against inadvertent entry. In some buildings, it may be feasible to lock appropriate doors, or limit access to very large work areas as a simple means of radiation area control. In other locations it MAY be necessary to establish boundaries by roping off, or barricading passageways at appropriate locations. In any event, sufficient control in the form of posting, use of safety monitors, and use of access limiting devices SHALL be in place to guarantee no individual can enter the area inadvertently.

- e. For night radiographic operations, sufficient lighting equipment to illuminate the area SHALL be used (exception: hangars with sufficient lighting available).
- f. A sufficient amount of barrier material SHALL be maintained on hand to support requirements (e.g. 250-ft coils of rope with supporting stands, commercially available barrier material, which states "CAUTION RADIATION AREA" with bright yellow background with magenta letters and radiation symbol, cones with radiation warning signs with or without attached lights, etc.).
- g. Place radiation warning signs (e.g. "Caution, Radiation Area") of sufficient quantity along the barrier so at least one can be seen from any direction of approach.

- h. Extend the power cable from the tube head to the control panel so the RIC is located as far as possible from the radiation source, usually at least 75-feet (23-meters). Place the control panel so all monitors, for the entire perimeter of the barrier, can be seen by the RIC. If this is not possible, an adequate means of communication SHALL be specified ([Paragraph 6.8.4.7](#)).
- i. An interlock system which:
 - (1) Is designed to prevent irradiation unless a properly functioning warning light is connected in the circuit.
 - (2) Is installed between the control unit and beacon ([Paragraph 6.8.6.2.2.4](#)).
 - (3) Has a 20-second pre-exposure audible alarm which functions simultaneously with beacons ([Paragraph 6.8.6.2.2.4](#)).
- j. A primary beacon which:
 - (1) Is a red rotating/flashing strobe-type beacon and in some situations, as specified by the IRSO, a radiation warning sign stating “X-RAY ON” when the light is lit.
 - (2) Does not use a low intensity flashing warning light ([Paragraph 6.8.6.2.2.3](#)).
 - (3) Is placed as close to the radiation source as possible, and still visible from all angles of approach.
 - (4) Is connected to an authorized interlock system, in such a manner the light will be ON when the radiation source is activated.
- k. Additional beacons may be used along with the primary beacon. An “X-RAY ON” warning sign or light is typically used at entrance location(s) to an unshielded facility and is lit during irradiation.
- l. Perform pre-operational checks of X-ray equipment in accordance with manufacturer’s instructions or suitable technical data prior to use.
- m. The interlock SHALL be inspected by radiographers prior to use to verify proper operation of audible, visible warning signals, and emergency shut-off switches (See TO 33B-1-2 WP 106 00 for Interlock Operational Check). A general purpose or AFTO Form 135 signed off by the individual conducting the inspection SHALL be maintained ([Paragraph 6.8.7.2.4](#)). Any malfunctioning safety device SHALL be appropriately serviced/repaired prior to use and re-inspected to verify proper operation.
- n. A thorough search for personnel working within the restricted area SHALL be conducted prior to activating the source (e.g. ensure no one is inside, on top, or below the object being radiographed). This step SHALL include facility/aircraft specific details.
- o. Control all entrances and exits into the restricted area during radiographic operations and adhere to radiation protection survey requirements. This step SHALL include facility/aircraft specific details.
- p. Operational, calibrated survey meters SHALL be available for immediate use for all personnel ([Paragraph 6.8.6.2.2.5](#) and [Paragraph 6.8.6.2.2.7](#)) during all radiographic operations. Survey meter checks SHALL be documented on the AFTO Form 140 ([Paragraph 6.8.7.2.5](#)).
- q. Announce (vocalize) “X-RAY ON” and “X-RAY OFF” prior to and post radiographic exposures.
- r. Perform warm-up of X-ray generator (if applicable) and operate in accordance with manufacturer’s instructions.

WARNING

Ensure the facility is surveyed for the maximum kilovoltage and milliamperage required for the Tube Warm-up Procedure.

- s. A qualified radiographer SHALL be present at the control panel during all radiographic exposures and will be the only person authorized to operate radiographic equipment.

NOTE

The RIC may only yield the controls when training NDI personnel. The RIC SHALL accompany the trainee during all aspects of the radiographic process and ensure strict compliance with technical order, radiation protection survey (scatter survey) and approved operating procedure.

- t. When a radiographic exposure has been completed, the safety-switch key SHALL be removed from the control panel. The RIC SHALL retain positive control of the safety-switch key at all times during radiographic operations. The safety-switch key SHALL not be left unattended in the control panel between individual exposures.
- u. When entering the restricted area after deactivation of the radiation source, personnel SHALL use a calibrated survey meter to ensure the source has returned to its “off” position (to ensure X-rays are no longer being produced).
- v. All information required on the AFTO Form 125/125A SHALL be recorded by the RIC ([Paragraph 6.8.7.2.2](#) and [Paragraph 6.8.7.2.3](#)).
- w. If the barrier is penetrated by anyone during the exposure, the radiation source SHALL be immediately turned off, the individual(s) detained, area secured, and the incident reported. Begin emergency procedure ([Paragraph 6.8.4.4.2](#) and [Paragraph 6.8.7.1](#)).

WARNING

Bioenvironmental engineering will approve all laser pointers prior to use and personnel will be trained in accordance with AFI 48-139, Laser and optical Radiation Protection Program. The Lorad Class 3R Laser Pointer SHALL NOT be directed above the horizon near the flight line, as this may be dangerous to flight operations. The laser will have a warning affixed to it, and it SHALL only be in the on position when aligning film and off at all other times. The laser will be treated as a dangerous tool and SHALL not be pointed at any individual.

- x. In the case of multiple exposures in an open area in which the beam direction, intensity (kV, mA) or attenuating materials are significantly altered, the barrier perimeter SHALL be re-established as required by the radiation protection survey.

6.8.6.2.3.2 Unshielded (Pulsed X-ray).

6.8.6.2.3.2.1 Establishment of Restricted Area for Pulse X-ray. A radiation protection survey ([Paragraph 6.8.4.5](#)) SHALL be accomplished to establish a restricted area. The following is an overview of pulse X-ray generation and typical radiation safety guidelines for the current pulsed X-ray systems used, approved operation and techniques, and a study completed by USAFSAM/OEC, but SHALL NOT be used as guidance in place of a radiation protection survey.

NOTE

If new pulsed X-ray systems are acquired with an X-ray tube head output greater than 3.5 mR/pulse at one foot from the tube head and/or a tube current rating greater than 0.5 mA, contact the AF NDI Office (AFLCMC/EZPT-NDIO) and the USAF School of Aerospace Medicine (USAFSAM/OEC).

6.8.6.2.3.2.1.1 The radiation scatter and primary beam footprint for pulsed X-ray operations is minimal. Additionally, low energy pulsed X-ray scatter radiation is difficult to accurately measure. Therefore, restricted area requirements defined be-

low ensure compliance with the general public exposure limits identified ([Paragraph 6.8.4.2.2](#)). Assumptions used for this determination included a total workload of 30,000 images per year, 27 pulses per image and up to 40 images per hour. An occupancy factor of 0.5 was used for determining compliance with the yearly limit. These restrictions are guidelines as each area authorized for radiation operations must have an initial radiation protection survey accomplished and documented by the IRSO.

- a. For vertical image projections, a 16-foot radius around the tube head is required. Additionally, the primary beam SHALL be controlled to 28-feet. For the occasional horizontal image projections, a 16-foot area SHALL be controlled to the sides and back of the tube head. On the target end of the tube head a 28-foot area must be controlled. The unit has a radiation cone angle of approximately 40-degrees.
- b. Trained NDI personnel SHALL always maintain a minimum distance of 12-feet from the tube head, and stay out of the primary X-ray beam to ensure radiation dose is ALARA.

6.8.6.2.3.2.2 Unshielded Pulsed X-ray Operating Procedures. The operating procedure is mandatory and SHALL be adhered to. It SHALL describe the actions or steps necessary to safely conduct an unshielded pulsed radiographic operation. The procedure SHALL be facility/location specific, clearly written and specify, but not be limited to the following:

NOTE

- The operating procedure SHALL be used as step by step guidance when performing radiographic operations. It SHALL be a standalone document. The facility/location SHALL be identified and the procedure tailored to the unshielded facility/location and setup.
 - Responsibilities for the Radiographer in Charge (RIC) ([Paragraph 6.8.2.4](#)), Radiation Safety Monitor(s) ([Paragraph 6.8.2.5](#)) and Radiation Safety Monitor Assistants, if applicable ([Paragraph 6.8.2.5](#)) SHALL be incorporated.
- a. A current radiation protection survey will be on file and used when performing radiographic operations ([Paragraph 6.8.6.2.2.5](#)).

NOTE

Prior to making an exposure, the area SHALL be surveyed ([Paragraph 6.8.4.5](#)) to establish patterns of any radiation fields that could be present and to determine the adequacy of barrier placement.

- b. All personnel SHALL be trained and practice the ALARA (As Low As Reasonably Achievable) concept ([Paragraph 6.8.3.2.2](#) and [Paragraph 6.8.4.1](#)).
- c. All radiographers participating in radiographic operations SHALL correctly wear an assigned OSL dosimeter and two properly calibrated pocket ion chamber dosimeters, with readings annotated on the AFTO Form 115 if applicable ([Paragraph 6.3.10.1](#) and [Paragraph 6.8.7.2.1](#)).

NOTE

EPDs do not accurately measure radiation in the pulsed (60-nanosecond) radiation environment.

- d. Restricted area boundaries are established and reestablished as required by the radiation protection survey ([Paragraph 6.8.6.2.2.2](#)).

NOTE

Once the restricted area is identified, it SHALL be adequately posted to ensure against inadvertent entry. In some buildings, it may be feasible to lock appropriate doors, or limit access to very large work areas as a simple means of radiation area control. In other locations it MAY be necessary to establish boundaries by roping off, or barricading passageways at appropriate locations. In any event, sufficient control in the form of posting, use of safety monitors, and use of access limiting devices SHALL be in place to guarantee no individual can enter the area inadvertently.

- e. For night radiographic operations, sufficient lighting equipment to illuminate the area SHALL be used (exception: hangars with sufficient lighting available).
- f. A sufficient amount of barrier material SHALL be maintained on hand to support requirements (e.g. 75-feet of rope with supporting stands, commercially available barrier material, which states "CAUTION RADIATION AREA" with bright yellow background with magenta letters and radiation symbol, cones with radiation warning signs with or without attached lights, etc.).
- g. Place radiation warning signs of each required type (e.g. "Caution, Radiation Area") of sufficient quantity along the barrier so at least one can be seen from any direction of approach.
- h. At least 12-feet of X-ray tubehead activation cord or as required by the radiation protection survey. The RIC SHALL be positioned so all monitors, for the entire perimeter of the barrier, can be seen. If this is not possible, an adequate means of communication SHALL be specified ([Paragraph 6.8.4.7](#)).
- i. The tubehead SHALL provide visual and audible indication of tube activation and require key activation.
- j. A thorough search for personnel working within the restricted area SHALL be conducted prior to activating the source (e.g. ensure no one is inside, on top, or below the object being radiographed). This step SHALL include facility/aircraft specific details.
- k. Control all entrances and exits into the restricted area during radiographic operations and adhere to radiation protection survey requirements. This step SHALL include facility/aircraft specific details.
- l. Operational, calibrated survey meters SHALL be available for immediate use for all personnel ([Paragraph 6.8.6.2.2.5](#) and [Paragraph 6.8.6.2.2.7](#)) during all radiographic operations. Survey meter checks SHALL be documented on the AFTO Form 140 ([Paragraph 6.8.7.2.5](#)).
- m. Announce (vocalize) "X-RAY ON" and "X-RAY OFF" prior to and post radiographic exposures.
- n. A qualified radiographer SHALL be present at the controls during all radiographic exposures and will be the only person authorized to operate radiographic equipment.

NOTE

The RIC may only yield the controls when training NDI personnel. The RIC SHALL accompany the trainee during all aspects of the radiographic process and ensure strict compliance with technical order, radiation protection survey (scatter survey) and approved operating procedure.

- o. When a radiographic exposure has been completed, the safety-switch key SHALL be removed from the tubehead. The RIC SHALL retain positive control of the safety-switch key at all times during radiographic operations. The safety-switch key SHALL not be left unattended in the tubehead between individual exposures.
- p. When entering the restricted area after deactivation of the radiation source, personnel SHALL use a calibrated survey meter to ensure the source has returned to its "off" position (to ensure X-rays are no longer being produced).
- q. All information required on the AFTO Form 125/125A SHALL be recorded by the RIC ([Paragraph 6.8.7.2.2](#) and [Paragraph 6.8.7.2.3](#)).
- r. If the barrier is penetrated by anyone during the exposure, the radiation source SHALL be immediately turned off, the individual(s) detained, area secured, and the incident reported. Begin emergency procedure ([Paragraph 6.8.4.4.2](#) and [Paragraph 6.8.7.1](#)).

WARNING

Bioenvironmental engineering will approve all laser pointers prior to use and personnel will be trained in accordance with AFI 48-139, Laser and optical Radiation Protection Program. The Lorad Class 3R Laser Pointer SHALL NOT be directed above the horizon near the flight line, as this may be dangerous to flight operations. The laser will have a warning affixed to it, and it SHALL only be in the on position when aligning film and off at all other times. The laser will be treated as a dangerous tool and SHALL not be pointed at any individual.

- s. In the case of multiple exposures in an open area in which the beam direction, number of X-ray pulses or attenuating materials are significantly altered, the barrier perimeter SHALL be re-established as required by the radiation protection survey.

6.8.7 Utilization Log.

6.8.7.1 Utilization Log Books. As a minimum, two separate utilization log books; one for shielded areas and the other for unshielded areas (if areas not utilized, a book is not required). The unshielded log book SHALL be subdivided to clearly identify each unshielded area and include its own set of utilization forms for each individual area (AFTO Form 115, AFTO Form 125, AFTO Form 125A, AFTO Form 135). All utilization log books SHALL contain as a minimum:

- a. Unit Radiation Safety Officer (URSO) Appointment Letter.
- b. Current radiation protection survey.
- c. Operating procedures approved in writing by the IRSO.
- d. Emergency procedure approved in writing by the IRSO.
- e. AFTO Form 115, 125, 125A, 135.
- f. Current Annual Radiation Assessment Report.

6.8.7.2 Utilization Logs.

6.8.7.2.1 AFTO Form 115, *Electronic Personal Dosimeter (EPD) & Pocket Ion Chamber Dosimeter Results Log.* Dosimeter readings for each individual SHALL be entered on the AFTO Form 115.

6.8.7.2.1.1 Documentation. The dosimeter results log SHALL be documented at the beginning and end of the radiographic operation, with one exception: any time a dosimeter is used by a different radiographer it SHALL have its reading documented prior to transfer, and it SHALL be reset to zero prior to use. The following information SHALL be recorded.

- a. BASE UNIT: Enter maintenance organization radiographer(s) are assigned to (e.g. Tinker AFB 507 MXS).
- b. DATE: Enter date in YYYYMMDD format (e.g., 20200610 for 10 Jun 2020).
- c. RADIOGRAPHER'S NAME: Print the name (first and last name as a minimum) of the radiographer (e.g., John Doe).
- d. X-RAY LOCATION: Identify location (e.g. building number, address, spot etc.).
- e. DOSIMETER SERIAL NUMBER: Enter the dosimeters serial number. Take care to NOT use the TMDE/PMEL identification number.
- f. DOSIMETER READINGS (mR), INITIAL & FINAL: Enter initial and final dose readings with unit of measurement. ONLY the numeric value is required to be recorded (e.g. 0.06).

6.8.7.2.1.2 Record Keeping. When a log is completed or no longer being used, the URSO will perform a supervisory review ([Paragraph 6.8.7.2.6](#)). Record of these exposures SHALL be maintained as required by AFRIMS.

6.8.7.2.2 AFTO Form 125, Industrial Radiography Utilization Log. The AFTO Form 125 SHALL be completed for all shielded and unshielded radiographic operations, as well as any suspected overexposures of personnel.

6.8.7.2.2.1 Documentation. The following information SHALL be recorded:

- a. ORGANIZATION: Enter maintenance organization radiographers are assigned to (e.g. 507 MXS).
- b. FORM USAGE: Enter a check mark or an "X" in the applicable box to indicate the type of facility utilized, or if documenting a suspected overexposure.

NOTE

Only one line entry is required as long as the X-ray beam is oriented in only one general direction. Separate line entries SHALL be made for each orientation the beam is pointed to complete the radiographic procedure/inspection.

- c. DATE: Enter date in YYYYMMDD format (e.g., 20200610 for 10 Jun 2020).
- d. SHIFT: Enter a check mark or an "X" in the applicable box to indicate the duty shift of the operation (e.g. 1 mid, 2 days, 3 swings). A new entry is required if the operation covers multiple shifts.

NOTE

Military rank is also appropriate for grade, e.g. TSgt., P01, etc.

- e. RADIOGRAPHER IN CHARGE: Print the name (first and last name as a minimum) and grade of the Radiographer in Charge (RIC). A new entry is required if the RIC changes (e.g., John Doe, E-6).
- f. X-RAY FACILITY LOCATION: Identify location (e.g. building number, address, spot etc.).
- g. AIRCRAFT MODEL & TAIL: Identify model number of aircraft (e.g., F-16) and tail (serial) number (e.g., 92-3890), of the part or component being inspected. This should be accomplished for both on/off-equipment maintenance. Leave blank if not applicable.
- h. PART/COMPONENT: Identify part or component nomenclature being radiographed. Similar parts/components from a specific radiographic inspection (e.g., weld cert tubes/sheets) may be grouped as a series, as long as the general X-Ray beam orientation does not change.

NOTE

Re-shots performed later in the shift or another day/shift will require an additional line entry.

- i. NUMBER OF EXPOSURES IN SERIES: Enter the number of exposures performed to complete a specific radiographic inspection. Multiple exposures are only authorized if the exposure series parameters do not change e.g., wing inspections will have multiple exposures with the same beam direction.
- j. MAXIMUM kV IN SERIES: Enter highest kV used to radiograph the part/component (e.g. 160).
- k. MAXIMUM mA IN SERIES: Enter highest mA used to radiograph the part/component (e.g., 5).
- l. MAXIMUM EXPOSURE TIME IN SERIES: Enter individual exposure time used to radiograph the part/component. (On series shots, enter the time of the longest single exposure.)
- m. SURVEY METER RADIATION PEAK LEVEL (MONITORING POSITIONS): Enter highest recorded survey meter reading (mR/hr) from predetermined points around the barrier. One monitor can observe survey meter readings from various locations. Refer to sketch drawing on the AFTO Form 125A to determine where the readings will be observed and recorded. Each number on the radiation level block used in the operation SHALL correlate with a number in the sketch. ONLY the numeric value is required to be recorded (e.g., Position 1: 0.5, Position 2: 1.0).

6.8.7.2.2.2 **Record Keeping.** When a log is completed or no longer being used, the URSO will perform a supervisory review ([Paragraph 6.8.7.2.6](#)). The URSO will print their name (first and last name as a minimum), grade, and then sign the log with their minimum signature (first initial and last name) and date in YYYYMMDD format (e.g., 20200610 for 10 Jun 2020). The completed form will be maintained for three (3) years.

NOTE

If a suspected overexposure occurs, any other documents generated during the subsequent investigation SHALL be filed with the respective utilization log.

6.8.7.2.3 **AFTO Form 125A, *Industrial Radiography Utilization Log Facility Drawing*.** The AFTO Form 125A SHALL be used in conjunction with the AFTO 125 for all shielded and unshielded radiographic operations, as well as any suspected overexposures of personnel. The completed form includes the approved location for radiographic producing equipment and personnel monitoring positions as determined during the Radiation Protection Survey and local operating procedures to assure safe operations.

6.8.7.2.3.1 **Documentation.** The following information SHALL be recorded:

- a. **ORGANIZATION:** Enter maintenance organization radiographers are assigned to (e.g., 507 MXS).
- b. **RADIATION PROTECTION SURVEY DATE:** Enter the date of the current radiation protection (scatter) survey in YYYYMMDD format for the facility being used (e.g., 20200610 for 10 Jun 2020).
- c. **AIRCRAFT MODEL:** Identify model of aircraft the part or component is attached to or removed from (e.g., F-16). Leave blank if not applicable.
- d. **PART NOMENCLATURE:** Identify part nomenclature to be radiographed. Similar part/components may be grouped as a series as long as the general X-ray beam orientation does not change (e.g., Leading Edge Torque Shafts, Weld Certification Tube/Sheet).
- e. **DETAILED DRAWING OF EXPOSURE AREA:** Prepare a detailed drawing of the exposure area in accordance with the parameters used during the Radiation Protection Survey and local operating procedures. The following must be identified:

NOTE

The organization will be required to provide location specific drawings of the facility and aircraft/part being radiographed. ALL applicable figures from the form's legend SHALL be used in the drawing.

- (1) Aircraft/part orientation or position.
- (2) Tubehead location, position, and beam orientation.
- (3) X-ray control box location. SHALL also be Radiographer in Charge (RIC) position and correlates with the number one position in the radiation level block of the AFTO Form 125.
- (4) Locations of monitors and assistants during the exposure.
- (5) Radiation warning beacons. Identify location of beacons in accordance with the radiation protection survey and operating procedure.
- (6) 2 mR/hr barrier position.

NOTE

Copies of each applicable AFTO Form 125A drawing are required to be filed with the AFTO Form 125 records when the log has been used to document the corresponding exposure(s). New AFTO Form 125A's do not need to be generated after the completion of an AFTO Form 125 as long as the information is still current.

6.8.7.2.3.2 **Record Keeping.** The URSO will perform a supervisory review ([Paragraph 6.8.7.2.6](#)) and sign the form after the completed exposure area drawing is placed in-use following the Radiation Protection Survey. The URSO will print their name (first and last name as a minimum), grade, and then sign the log with their minimum signature (first initial and last name) and date in YYYYMMDD format (e.g., 20200610 for 10 Jun 2020).. The completed form will be maintained on file with the completed AFTO Form 125 for three (3) years.

6.8.7.2.4 **AFTO Form 135, *Interlock Operational Check Log*.** The AFTO Form 135 or a general purpose form SHALL be used to document interlock operational checks for shielded and unshielded interlocks. In the absence of commercial manufacturer instructions, a procedure to perform the operational check is published in TO 33B-1-2, WP 106 00 for use.

6.8.7.2.4.1 **Documentation.** The following information SHALL be recorded:

- a. ORGANIZATION: Enter maintenance organization radiographers are assigned to. (e.g., 507 MXS).
- b. FORM USAGE: Enter a check mark or an "X" in the applicable box to indicate the type of facility utilized.
- c. INTERLOCK SYSTEM: Identify the manufacturer and serial or identification number of the interlock system used. (e.g., Technical Services Group-TSG.50101370086).
- d. X-RAY FACILITY LOCATION: Identify location (e.g., building number, address, spot, etc.).
- e. CURRENT RADIATION PROTECTION SURVEY: Enter the date of the current radiation protection (scatter) survey in YYYYMMDD format for the facility being used (e.g., 20200610 for 10 Jun 2020).
- f. DATE: Enter date of inspection in YYYYMMDD format (e.g., 20200610 for 10 Jun 2020).
- g. PASS/FAIL: Enter a check mark or an "X" in the applicable box to indicate the results of the operational check.
- h. PRINTED NAME: The qualified radiographer performing the check will print their name (first and last name as a minimum) (e.g., John Doe).
- i. SIGNATURE: The qualified radiographer performing the check will sign the log with their minimum signature (First initial and last name).
- j. GRADE: Enter the grade of the qualified radiographer performing the check (e.g., E-5, WG-10, etc.).

6.8.7.2.4.2 **Record Keeping.** When the log is completed or no longer being used, the URSO will perform a supervisory review ([Paragraph 6.8.7.2.6](#)). The URSO will print their name (first and last name as a minimum), grade, and then sign the log with their minimum signature (first initial and last name) and date in YYYYMMDD format (e.g., 20200610 for 10 Jun 2020). The completed form will be maintained on file for six (6) months.

6.8.7.2.5 **AFTO Form 140, *Radiac Equipment Maintenance Record*.** The AFTO Form 140 SHALL be used to document operational checks for radiation survey instruments (survey meters). A procedure for Fluke Biomedical (formerly Victoreen) 450P, 451B, and 451P model survey meters is published in TO 33B-1-2 WP 106 00. When performing operational checks on SM-400 model survey meters, users SHALL follow the steps published in TO 11H4-7-15-1.

6.8.7.2.5.1 **Documentation.** The following information SHALL be recorded:

- a. ORGANIZATION: Enter maintenance organization radiographers are assigned to (e.g., 507 MXS).
- b. MODEL & SERIAL NUMBER: Enter model and serial number of survey meter (e.g., SM-400, 583-0671).
- c. STORAGE LOCATION: Enter location (e.g., building number or street address) of where equipment is stored or WWID (Worldwide Identification)/tool room unique identification code.
- d. APPLICABLE T.O: Enter T.O used for operating procedures.

NOTE

The baseline value and 20% acceptable range is ONLY required to be documented for Fluke Biomedical (formerly Victoreen) 450P, 451B, and 451P model survey meters. All baseline information will be transferred to a new form if the log has been completed and the survey meter's base line value following TMDE calibration is current.

- e. **BASE LINE VALUE:** Enter mR/hr value obtained from the baseline (initial) operational check from the radiation check source after the survey meter has returned from TMDE calibration. Leave blank if not applicable.
- f. **20% ACCEPTABLE RANGE:** Enter the acceptable $\pm 20\%$ range of the base line value. Leave blank if not applicable.
- g. **DATE:** Enter date of inspection in YYYYMMDD format (e.g., 20200610 for 10 Jun 2020).
- h. **BATTERY CHECK:** Enter Good or Bad to indicate the results of the battery check.
- i. **SOURCE CHECK READING:** Enter the mR/hr value obtained from the source during the operational check (e.g., 1.5 mR/hr).
- j. **PASS/FAIL:** Enter a check mark or an "X" in the applicable box to indicate the results of the operational check.
- k. **SIGNATURE:** The qualified radiographer performing the check will sign the log with their minimum signature (first initial and last name).
- l. **GRADE:** Enter the grade of the qualified radiographer performing the check (e.g., E-5, WG-10, etc.).

6.8.7.2.5.2 Record Keeping. When a log is completed or no longer being used, the URSO will perform a supervisory review ([Paragraph 6.8.7.2.6](#)). Logs will be closed out once a survey meter has been serviced or has received TMDE calibration. Following TMDE calibration, a new form is required to be initiated. Records SHALL be maintained as required by AF-RIMS.

6.8.7.2.6 Supervisory Review of Utilization Logs. When a utilization log is complete or no longer being used, a supervisory review SHALL be conducted on the individual document. A thorough review will be performed to ensure all required information is present and no discrepancies exist. A comprehensive supervisory review of ALL utilization logs should be conducted every 90 days, but SHALL not exceed 180 days. The comprehensive review compares all utilization logs, ensuring each log is properly documented, contains all required information and no discrepancies exist. Identified discrepancies SHALL be corrected prior to filing for either review process. Supervisory reviews SHALL be accomplished by the URSO.

6.8.8 Radiation Areas and Facilities.

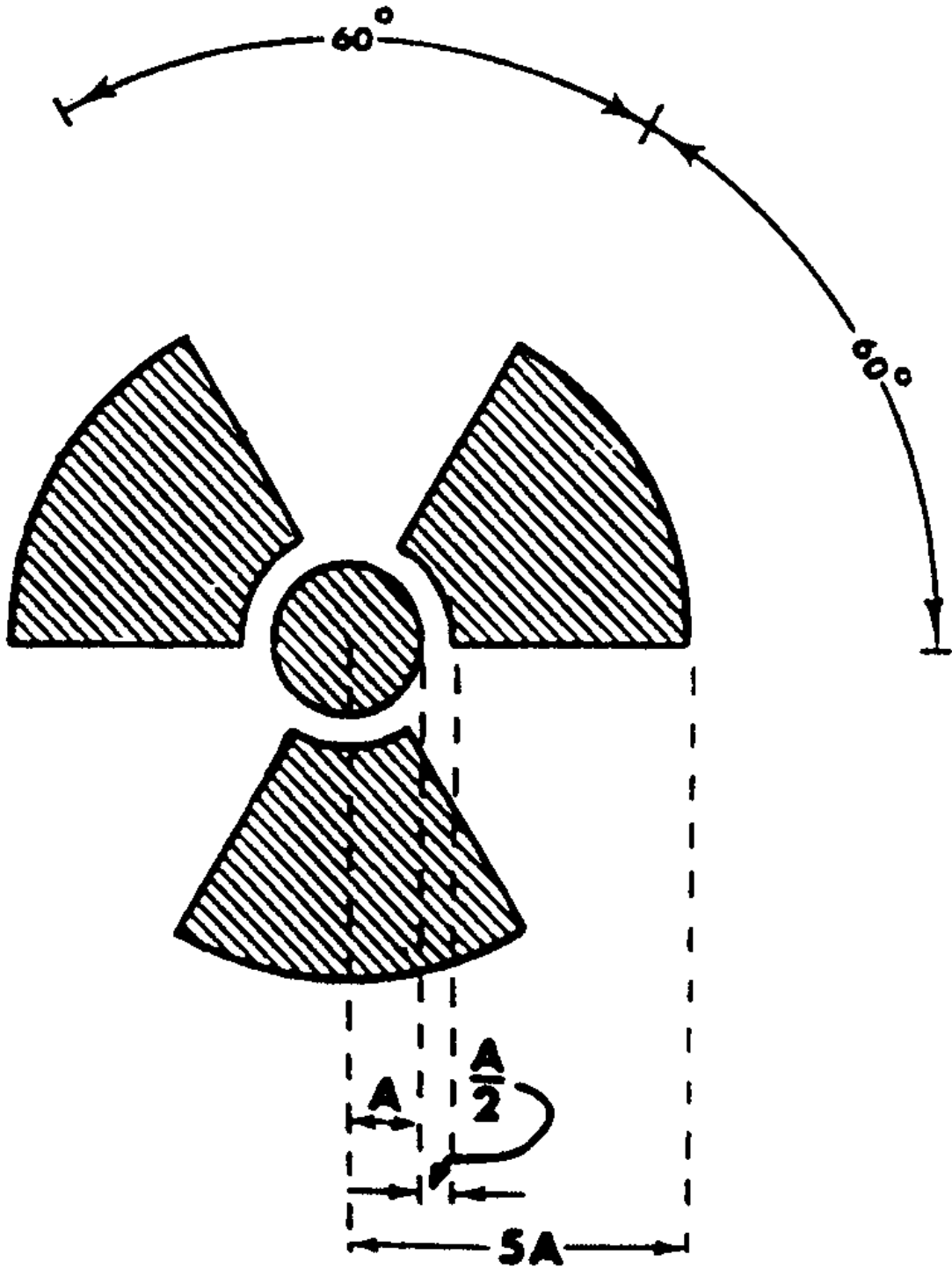
6.8.8.1 High Radiation Areas. Each of the types of installations specified herein involves the creation of "High Radiation Areas." To ensure high levels of safety, these rules stated in 10 CFR 20.10601 will also be applied to radiographic operations performed with X-ray sources. Requirements include one or more of the following features:

- a. Control devices that, upon entry into the area, cause the level of radiation to be reduced (below that level at which an individual might receive a deep-dose equivalent of 100 mrem (1 mSv) in 1 hour at 30-centimeters from the source (or from any surface that the radiation penetrates).
- b. Control devices that energize a conspicuous visible or audible alarm such the individual entering the area, and the supervisor of the activity, are made aware of the entry.
- c. Entries that are locked, except during periods when access to the areas is required, with positive control over each entry.
- d. Continuous direct or electronic surveillance capable of preventing unauthorized entry.

6.8.8.2 Very High Radiation Areas. A "Very High Radiation Area" is an area in which radiation levels could be encountered at 500 rads (5 gray) per hour at one-meter from a radiation source or from any surface that the radiation penetrates (10 CFR 20.1602). Additional measures SHALL be instituted to ensure that an individual is not able to gain unauthorized or

inadvertent entry into a "Very High Radiation Area." The requirements of 10 CFR 20.1602 SHALL be implemented for all radiation sources, including X-ray machines, which create very high radiation areas.

6.8.8.3 New Facilities. New radiation facilities SHALL be constructed to meet the requirements of shielded installations ([Paragraph 6.8.6.1.1](#)).



H0402941

Figure 6-73. Radiation Symbol

6.8.8.4 NDI Facility Design and Modification.

6.8.8.4.1 Determining Shielding Requirements. The structural shielding requirements of any new installation or of an existing one in which changes are contemplated, MAY be decided by a Health Physicist, Radiological Physicist, Nuclear Medicine Science Officer, or a qualified Bioenvironmental Engineer. To adequately determine shielding requirements, the following data concerning the source of radiation SHALL be provided:

- a. Type of radiation source (e.g., X-ray).
- b. Maximum and average tube potential (kilovoltage).
- c. Maximum and average tube current (milliamperage).
- d. The expected workload in milliamperere minutes (mA-min) per week.
- e. The use factors for each wall, floor, and ceiling as appropriate. This is the fraction of the workload during which the useful beam is pointed in the direction under consideration ([Table 6-26](#)).
- f. The type of occupancy of all areas which might be affected by the installation ([Table 6-27](#)). The structural details of the building. This will include a dimensioned drawing of the facility, with notation of the typical distances from the X-ray source to each barrier of the facility, as well as the expected construction materials for the facility. Collimated Sources (e.g.,40 deg cone).

Table 6-26. Use Factors (U)*

Installation Use	Shielded	Open Sources
	Collimated Sources (e.g.,40 deg cone)	(e.g., Panoramic)
Floors	1	1
Walls	1/4	1
Ceilings	1/16	1

* For use as a guide in planning shielding when complete data is not available.

Table 6-27. Occupancy Factors (T)

Full Occupancy (T = 1)	X-ray control space and waiting space, darkrooms, film reading areas, workrooms, shops, offices, and corridors large enough to hold desks, living quarters, children’s play areas, occupied space in adjoining buildings.
Partial Worker Occupancy (T = 1/4)	Worker restrooms, occupational use corridors too narrow for desks.
Partial Occupancy (T = 1/8)	Public corridors too narrow for desks, utility rooms, and employee lounges.
Occasional Public Occupancy (T = 1/20)	Rest rooms or bathrooms, storage rooms, vending areas, outdoor areas with seating.
Rare Occupancy (T = 1/40)	Outside areas used only for pedestrians or vehicular traf- fic, unattended parking lots, attics or crawl spaces, stair- ways, unattended elevators, janitors closets.

* For use as a guide in planning shielding where adequate occupancy data are not available.

6.8.8.4.2 Direction of Useful Beam.

- a. Although the cost of shielding MAY be reduced significantly by arranging the installation so the useful beam is not directed toward occupied areas, the cost of shielding SHALL NOT override potential safety concerns. However, since weapon system requirements can change during the useful life of a facility, shielding SHALL be adequate enough for any potential future requirements.
- b. Devices that permanently restrict the direction and cross section of the useful beam MAY reduce the area requiring primary barriers.

6.8.8.4.3 Radiation Energy, Output, and Workload. The shielding for each occupied area SHALL be determined on the basis of the expected maximum use kilovoltage or energy, mA workload, use factor, and occupancy factor affecting it. Consideration SHOULD be given to the possibility the values of these parameters MAY increase in the future. It MAY be more economical to provide a higher degree of protection initially than to add to it later.

6.8.8.4.4 Structural Details of Protective Barriers. Shielding for radiographic installations is normally provided by installation of sheet lead or concrete. Facilities with high workloads MAY use a combination of these materials, or use concrete loaded with high iron content aggregate to improve shielding efficiency. The half-value layers of lead and concrete (the thickness of each material necessary to reduce the exposure intensity by a factor of two) for various energy X-rays are shown in [Table 6-28](#).

Table 6-28. Peak Voltage (kV)

HALF-VALUE AND TENTH-VALUE LAYERS						
Attenuation Material						
Peak Voltage	Lead (mm)		Concrete (cm)		Steel (cm)	
	HVL	TVL	HVL	TVL	HVL	TVL
70	0.17	0.52	0.84	2.8		
100	0.27	0.88	1.6	5.3		
125	0.28	0.93	2.0	6.6		
150	0.30	0.99	2.24	7.4		
200	0.52	1.7	2.5	8.4		
250	0.88	2.9	2.8	9.4		
300	1.47	4.8	3.1	10.4		
400	2.5	8.3	3.3	10.6		
500	3.6	11.9	3.6	11.7		
1000	7.9	26	4.4	14.7		
2000	12.5	42	6.4	21		
3000	14.5	48.5	7.4	24.5		
4000	16	53	8.8	29.2	2.7	9.1
6000	16.9	56	10.4	34.5	3.0	9.9

6.8.8.4.5 Quality of Protective Material. All shielding materials SHALL be of assured quality, uniformity, and permanency.

6.8.8.4.6 Lead Barriers. Lead barriers SHALL be mounted in such a manner they will not cold-flow because of their own weight and SHALL be protected against mechanical damage. Additionally, lead sheets at joints SHOULD be in contact with a lap of at least one-half inch, or twice the thickness of the sheet, whichever is greater. Welded or burned lead seams are permissible provided the lead equivalent of the seams is not less than the minimum requirement.

6.8.8.4.7 Joints Between Different Materials or Structures. Joints between different kinds of protective materials SHALL be constructed so the overall protection of the barrier is not impaired. Additionally, joints at the floor and ceiling SHALL be constructed so the overall protection is not impaired.

6.8.8.4.8 Shielding of Openings in Protective Barriers. In the planning of an installation, careful consideration SHOULD be given to reducing the number and size of all perforations of protective barriers and openings into the protected areas. Protection for all such openings SHALL be provided by means of suitable protective baffles.

- a. Perforations. Provision SHALL be made to ensure nails, rivets, or screws which perforate lead barriers are covered and give protection equivalent to the imperforated barrier.
- b. Openings for Pipes, Ducts, Conduits, Louvers, etc. Holes in barriers for pipes, ducts, conduits, louvers, etc., SHALL be provided with baffles to ensure the overall protection afforded by the barrier is not impaired. These holes SHOULD be located outside the range of possible orientations of the useful beam.
- c. Doors and Observation Windows. The lead equivalent of doors and observation windows of exposure rooms, cubicles, and cabinets SHALL NOT be less than required for the walls or barrier in which they are located.

6.8.8.4.9 General Requirements for Doors.

- a. Location of Doors. Where practical, doors into exposure rooms SHOULD be located so the operator has control of access to the room.
- b. Interlock Switches for Doors. All door(s) and panel(s) opening into an X-ray exposure room or cabinet (except those opened or removed only with tools) SHALL be provided with single interlocking switches preventing irradiation unless the door or panel is closed. Double doors SHALL have interlock switches that operate independently of each other.
- c. Resumption of Operation. If the opening of a door or panel to a "Shielded" Installation has interrupted the operation of any radiation source, it SHALL NOT be possible to resume operation by merely closing the door or panel in question. To resume operation, it SHALL be necessary to re-energize the source at the console, and this procedure SHALL cause the time delay interlock system to be re-initiated. It SHALL NOT be possible to resume operation by merely re-engaging the interlock.
- d. Escape or Interruption of Irradiation from Inside Exposure Room. The exposure room SHALL include at least one means of exit that MAY be rapidly opened from the inside. A suitable means SHALL be provided to quickly interrupt irradiation from inside the room. The means of accomplishing this SHALL be explained to all personnel and a sign explaining its use SHALL be conspicuously posted inside the exposure room. Preferably, the beam SHOULD NOT be directed toward the door or interrupting device.
- e. Threshold Baffle for Door Sill. A door baffle or threshold will generally be required for radiography sources and for installations operating above 125 kV.
- f. Lap of Doorjamb. The protective lead covering of any door leading to an exposure room or cabinet SHALL overlap the doorjamb and lintel so as to reduce the radiation passing through clearance spaces to the allowable limit for the door itself.

SECTION IX DIGITAL RADIOGRAPHY

6.9 FUNDAMENTALS OF DIGITAL RADIOGRAPHY.

6.9.1 Capture. Digital radiographic images are "captured" in many different ways in industrial radiography. Some methods involve the use of standard radiographic film, "film based capture" or film designed with digitization in mind. Other methods bypass using film altogether and use direct or indirect capture methods, "filmless capture." All rely on taking an analog signal and converting it to a sampled digital form using solid state "charged coupled device (CCD)" sensors, photovoltaic cells, or photo-multiplier tubes from the analog signal.

6.9.2 Basic Image Types. Image types could be classified as continuous and discrete. Discrete (distinct from each other) values are digital images and the continuous (variables flow into the next) are considered to be similar to regular film images. These definitions are the basic definitions in any mathematics or scientific discipline. Continuous can be converted to discrete variables. Digitization of continuous variable is a common practice. Digital imaging techniques allow us to retrieve information electronically for easy and accurate manipulation or analysis by computer. Digital images vary from traditional images in the way the image information is represented.

6.9.3 Transition from Film to Filmless. The process to transition from film to a filmless technology depends largely on the application and the type of filmless technology. Computed utilizes flexible phosphor plates that are handled similarly to film making then a more natural transition for film applications. Indirect and direct capture systems such as digital detector arrays (DDA) are rigid panels with sophisticated electronics that allow for near time or real time image capture, more suited to laboratory environments or automated applications.

6.9.3.1 Analog versus Digital Images. Traditional images, like the image that appears on an industrial radiographic film, are made up of continuous tones. We can get an electronic representation of the continuous tones with an analog waveform generated by some measuring device. Sampling discrete sections of the waveform and storing the sampled value as strings of ones and zeros (the only digits used in modem computing equipment) produce digital images.

6.9.4 Film Based Capture. Three methods generally used for the digitization of radiographic film. "Laser scanners" (considered the most accurate for brightness or resolution), "CCD scanners" (which although they do not perform as well for brightness or resolution, are available for higher spatial resolution than laser scanners), and the "CCD camera" aimed at a lightbox. Film scanners can convert the analog image of film into a digital image that can be shared, manipulated, and annotated electronically.

6.9.4.1 Laser Scanners. Laser scanners utilize a laser beam that passes through the film and the resulting light is converted to a voltage signal by a photomultiplier tube. The voltage values are sampled over time to produce a digital image with brightness values calibrated to optical density values.

6.9.4.2 CCD Scanners. CCD scanners use a charge-coupled device as a detector. For digital radiography purposes, the CCD is generally an array of thousands of tiny photocells that create pixels for a line of the scanned radiograph as the image is passed over it, illuminated by a fluorescent lamp. Home and desktop photographic scanners are much like the CCD scanners, except home scanners are generally not set up to handle transparency data as in a radiographic film.

6.9.4.3 CCD Camera. The least expensive of systems are generally composed of a digital camera focused on an area of a lightbox with a radiographic film placed upon it. The camera takes a digital picture using a two dimensional, CCD array of the area of the radiograph focused upon. These systems can be difficult to calibrate and depending upon the limitations of the camera CCD size, often can be used to take quality digital images of only small portions of the radiograph at a time.

6.9.4.4 Filmless Capture. Radiographic film is not always needed or desired for digital radiography. Several alternatives to film are available today. Let us briefly discuss the two methods ("indirect" and "direct") of capture, and the devices used for filmless capture.

6.9.4.4.1 Indirect Capture. Indirect capture may be the most popular form of filmless digital radiography; this may be due to it being the easiest form to implement, and also due to a wide availability of indirect capture hardware. Indirect capture utilizes a means of converting X-ray light into visible or near visible light that can be detected and measured by photomultiplier tubes, CCD or other photo cells. Computed radiography, a photo luminescence method, is a two step radiographic imaging process. A storage phosphor imaging plate is exposed to penetrating radiation and the luminescence from the plate's photostimulated luminescent phosphor is detected, digitized, and presented via monitor or hard copy. The following are some devices used for indirect capture of images:

6.9.4.4.2 Phosphor Screens. Phosphor screen based systems are the most like traditional film based radiography. A special capture system X-ray sensitive plate or screen captures radiographic information and is then placed in a digitizer or reader to convert the information into a digital image. The plates can be either rigid or flexible, depending upon the hardware used, and are reusable. Phosphor filmless imaging is a very popular method of digital radiography because of the ease of use, and film like nature of the process. Phosphor screens in computed radiography use are referred to as imaging plates (IP).

6.9.4.4.2.1 Indirect Capture, Amorphous Silicon Plates. These devices are sometimes called "direct capture" devices because they seem to work by directly capturing X-ray data and at first glance are indistinguishable from true direct cap-

ture devices, but in truth, they are indirect capture devices because they use a scintillating crystal to convert X-ray light into visible light, which is sampled by the photovoltaic array they contain. Amorphous silicon plates generally require the use of a lab environment, as they are directly connected to the computer for digitization.

6.9.4.4.3 Direct Capture. Direct capture systems use selenium or some other material that produces a voltage when exposed to high energy radiation. Aside from this, they work in basically the same manner as an amorphous silicon plate. Selenium based systems can sometimes be overly responsive to external factors. These factors, such as ambient heat and high radiation can sometimes damage the device. These systems require indoor lab use with controlled conditions.

6.9.4.4.4 Digital Detector Arrays. Amorphous silicon and amorphous selenium, also referred to as DDA systems have the capability of producing filmless images in a very short time, with no mechanical moving parts. The image acquisition time is usually fixed at 5 to 10-seconds, leaving the dose to be controlled by adjusting the mA. The optimum kV is typically 5 to 10-percent less than film. DDA systems can be used for real time observation or images stored on the computer for analysis and archiving. DDAs are of fixed sizes and rigid making use somewhat limited. DDAs can function for several years depending on radiation exposure, sensor decay or failure and handling. Shielding on the array electronics can extend the DDA life.

6.9.4.4.4.1 Geometric Magnification. Although DDAs often have lower spatial resolution than phosphor plate systems, these systems are often used with micro-focus X-ray tubes that allow for significant geometric magnification while still maintaining the required image unsharpness. This magnification can result in spatial resolution far superior to what can be achieved with a conventional X-ray tube and phosphor plates (or film). In addition, the inherent frame averaging capability of these systems can drastically improve signal-to-noise ratio (SNR), providing excellent image quality.

6.9.4.4.4.2 DDA Handling. These systems are excellent choices for factory and laboratory environments where handling of the panel is kept to a minimum in an X-ray cabinet or vault. Positioning these devices on aircraft can be difficult and cumbersome. DDAs use in industrial radiography is increasing. Manufacturers have hardened the DDA to withstand handling in field environments. An advantage is images are captured directly to the computer eliminating processing of film or scanning an IP.

6.9.4.4.5 Digital Cameras. Like the amorphous plates, they can produce real time images and incorporate the use of a scintillating crystal to convert X-ray light into visible light for capture. They tend to have much smaller CCD arrays compared to amorphous silicon systems, but can focus on smaller areas of a part in real time. Digital camera based, CCD, or image intensifier all use the light that is generated off another medium, that is, light emitting phosphor screen. This image is then digitized and displayed. This process can either be real-time or still images.

6.9.5 Computed Tomography. X-ray computed tomography (CT) is a three-dimensional (3D) radiographic nondestructive inspection (NDI) technique used extensively in the medical community and also for inspection of complex, high value, aerospace engine components. CT is a nondestructive inspection technique used to locate and size volumetric details in an object. An X-ray source irradiates an object at different angles and the transmitted radiation is detected by either a linear or 2 dimensional (2D) DDA. Detectors are comprised of very small elements that convert the X-ray energy to voltage values which are then converted to individual pixel intensity values. For a 2D detector array, these intensity values are combined to produce a 2D image also known as an image projection. The image projections captured at all inspection angles are then reconstructed with the aid of a computer to create a 3D image of the object under examination. A material's density, element number (attenuation coefficient) and geometry affect the attenuation of radiation within a part. Defects attenuate radiation differently than the base material and thus have a different appearance on the resulting X-ray 3D reconstruction. CT can be used to identify, locate and size defects as well as image/measure part geometry.

6.9.5.1 CT Applications. Aside from its many uses in the medical field, the industrial sector uses CT for various applications. Some of the more common applications include assembly analysis, metrology, creating models for software analysis (i.e. finite element), and reverse engineering. Material defect detection is less common but has been used for geometrically complex parts made with casting or additive manufacturing processes.

6.9.5.2 CT Disadvantages. Due to cost, size, and complexity of CT systems, this tool is primarily used in R&D or engineering analysis environments. Parts to be examined must be small enough to fit within the CT cabinet and light enough to allow the rotational stage to rotate smoothly. Spatial resolution capability decreases with increasing part size because of geometric magnification limitations (i.e. source-to-object distance is limited by part size). Large density or thickness changes can cause excessive scatter and effectively mask areas of interest. Defect types with little to no volume (i.e. fatigue cracks) can be difficult to detect. Inspection times can range from minutes to hours depending on part size and desired sensitivity.

6.9.6 Binary System. Computers use the binary system to store data. The term used to store data is the bit from binary digit with values of 0 and 1. Common practice is to combine eight bits called a byte. A byte represents 256 values from 0 to 255 and is expressed as 2 to the 8th power or 2^8 . Common computed radiography systems have bit or pixel depths of 14 or 16 bits providing 16,384 and 65,536 values.

6.9.7 Pixels. Digital images displayed or stored in a grid made up of pixels. Each pixel is a horizontal and vertical location determined from position on the detector. Each pixel location of a stored image contains the gray scale value from the computed radiography system or physical sensor location for DDAs. The smaller the pixels, the greater the spatial resolution of the system. Viewing monitors for digital system require small pixels in order to adequately view an image. For computed radiography a minimum 3 megapixel (MP) monitor is required. For a 21 inch 3MP monitor the pixel size is approximately 8 mils (0.008 inch).

6.9.7.1 Pixel Depth. Pixel depth is the measure of brightness resolution in a digital image. Here is the way in which it works for common pixel depths:

6.9.7.1.1 1-Bit Pixel. A 1-bit pixel depth image can be made up of, at the most, only two colors, generally black and white. Each pixel is represented in memory as either a one or a zero. Gray values are simulated by grouping black and white pixels over an area to make it appear brighter or darker. Fax machine printouts and even black and white newspaper photographs are examples of 1-bit images.

6.9.7.1.2 8-Bit Pixel. An 8-bit pixel image can display 256 colors or grayscale levels at the most. They are comprised of individual pixels made up of eight bit each, yielding 2 to the 8th power brightness (or color) levels. Color images are represented by using the brightness information of the pixel as a value to use in a table of color values. Web based images with a "GIF" extension, and many grayscale computer displays are examples of 8-bit graphics.

6.9.7.1.3 12-Bit Pixels. 12-Bit images are almost always grayscale images. The value of the pixel is made up of 12 bits which equates to 4096 individual gray scale values.

6.9.7.1.4 24-Bit and Higher. 24-Bit and higher color images (also known as "true-color" images) group three or more 8-bit bytes of brightness information together. Each byte represents a color channel (or an alpha transparency channel) of brightness. The effect is one of millions of colors, but with the same overall brightness resolution of an 8-bit, grayscale image. There is no difference in a 24-bit grayscale image and an 8-bit grayscale image as far as quality is concerned.

6.9.8 Graphic Information. There are two ways in which computers handle graphic information. The two methods are known as "Vector" and "Raster" graphics.

6.9.8.1 Vector Graphics. In vector graphics, any image created remains separate from others. Images are described mathematically and are not tracked in pixels. Vector graphics are the graphics created in drawing and illustration programs, like clipart in word processing packages. These graphics are stored as a collection of objects described mathematically using shape, line segments, and arcs. Vector graphics are also known as object-oriented graphics because of its use of an object model to describe the mathematical shapes that construct an image.

6.9.8.2 Raster Graphics. Raster graphics, also known as bit-mapped graphics, are created by scanners and digitizers. Raster images are comprised of a two dimensional array of discrete pixels (like a computer monitor screen). A bitmap is a file that indicates a color for each pixel along the horizontal and vertical axis. Raster and bitmap images are used interchangeably. They both refer to a color format where the image is composed of either black or white pixels. Working with raster images means working with pixels, not objects or shape. Each pixel in an image is stored in its own location within computer or storage memory as a number representing color and brightness (and sometimes transparency) or other levels. Because storing formulas for drawing shapes takes less memory in general than actually mapping out the individual pixels of the image, vector graphics tend to be much smaller in size than raster or bitmapped images.

6.9.9 Compression. Image compression techniques for digital images fall into two main categories, "lossless" and "lossy" compression.

6.9.9.1 Lossless Compression. Lossless compression techniques are the only compression algorithms universally accepted by the industrial digital radiography community. In a lossless compression algorithm, the original raw data can always be reconstructed exactly as it was before compression. There is no loss of the original information; it is just coded in a way that is smaller for storage.

6.9.9.2 **Lossy Compression.** Lossy compression algorithms sacrifice some of the image data to create even smaller file sizes while trying to maintain the overall quality of an image. The amount of loss can vary in most techniques, and is determined by the compression quality factor used in the compression algorithm. Lossy compression algorithms degrade an image over each subsequent compression from a decompressed image in a manner similar to making a noisy copy of an analog cassette tape, then making a copy of a copy, using the same equipment. The original raw data is lost and irretrievable in a lossy compression algorithm. Examples of lossy compression include: “Discrete Cosine transform” compression, standard “JPEG” compression, and “wavelet” compression methods. Of these, wavelet compression tends to produce the highest quality copy with a high compression ratio and low image loss.

NOTE

Lossy compression is not recommended for anything but copies of digital radiographs.

6.9.10 **Digital Image Resolution.** The quality of bit-mapped graphics is determined at capture or resampling time by two factors of resolution: “brightness resolution” and “spatial resolution.”

6.9.10.1 **Brightness Resolution.** The brightness resolution is also referred to as the grayscale or color range of an individual pixel. Brightness resolution is defined in a digital image by the pixel it represents. The value can be made of one or more bits. The more bits actually used to define the brightness levels in a digital image, the higher the brightness resolution (and hence the quality) of the image ([Paragraph 6.9.7.1](#)). Brightness resolution is also known as pixel depth.

6.9.10.2 **Spatial Resolution.** Spatial resolution is the number of pixels horizontally and vertically in a digital image. Spatial resolution of a digital image determines the actual size of the pixel in real units, and thus is determined by the sampling interval of the original digitization operation. A longer interval produces lower spatial resolution images while a shorter interval produces higher spatial resolution. The term “resolution” when not preceded by spatial or brightness generally refers to spatial resolution.

6.9.11 **Digital Image Quality Factors.** Image quality of a scanned or digitized image is dependent upon pixel size, spatial resolution, and the pixel depth (brightness resolution). The sampling time for a given area is generally proportional to the spatial resolution (number of pixels per square inch or square millimeter) and to the brightness resolution (bits per pixel). Generally, digital capture systems and scanners allow you to set these values up to the limit of the hardware. It is not always necessary to do so for all shots. Entrapped water detection, for example, would benefit from the highest brightness resolution, but would not require the highest spatial resolution. Also, the size of the stored image in bytes is directly proportional to the image spatial resolution so it does not make sense to perform every capture at the highest possible quality. The procedure and part SHOULD dictate the resolution settings to use for digital capture. There are other factors that affect the quality of a captured digital image introduced as part “noise” of the capture process itself. Other factors are “dynamic range,” and “artifacts.”

6.9.11.1 **Noise.** Noise is defined by ASTM as the data present in a radiological measurement which is not directly correlated with the degree of radiation attenuation by the object being examined. Scatter within the image, variations in the phosphor plate or DDA and electronic induced noise all contribute to the degradation of the image. Noise creeps into a digital radiograph in a couple of ways. There is the noise inherent in radiography, and can generally be kept to a minimum by using the proper and prescribed techniques. There is also the noise in the digital capture hardware. The modulation transfer function (MTF) is used to measure the signal-to-noise ratio. This SHOULD be considered a factor when deciding upon a digital capture system for a particular application.

6.9.11.2 **Dynamic Range.** Dynamic range is the effectiveness of the scanner or capture hardware in differentiating between differing shades of gray or brightness. It is a measurement of the number of bits used to represent each pixel in a digital image also referred to as pixel value (PV). Phosphor plate capturing systems tend to excel in the dynamic range department while film digitizers tend to have a breakdown level toward the higher densities. The greater the dynamic range, the higher the contrast and color/ grayscale bit depth.

6.9.11.3 **Artifacts.** Artifacts are unwanted images caused by input or output process, that is, hardware or software. Images like films are subject to artifacts created during image capture. Artifacts, such as dust and fingerprints, can also harm the quality of a digital image. Many times, artifacts are hard to distinguish from actual indications on an image because of the nature of digital imaging. It is important to keep the capturing hardware clean and to cover digitizers and scanners when they are not in use to minimize artifacts.

6.9.11.4 Sampling time, or rate, is related to the signal frequency and under or over sampling may result in data loss. When the sampling time is low, artifacts such as aliasing or Moiré patterns may occur. For example, aliasing is evident in line pairs when sampling is inadequate ([Figure 6-74](#)).



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Figure 6-74. Aliasing in Line Pairs

6.9.12 Digital Radiographic Viewing, Storage, Archival, and Printing Systems.

NOTE

DICONDE is the preferred format for saving digital images.

6.9.12.1 Viewing Systems. Digital radiographs are viewed on systems primarily designed for digital radiography. The systems differ from ordinary image processing systems for home and photographic use in that they are tailored specifically for radiography. Systems SHOULD provide at least all the functionality discussed in this section to allow you to be an effective digital radiographer. Hardware for digital radiography is designed with radiography in mind, the computer for running the software and the interfaces to the acquisition hardware are all specialized pieces of equipment designed to handle large radiographic images with little chance of data corruption or image alteration.

6.9.12.2 Monitors. Generally, grayscale monitors are used for digital radiography with a portrait oriented large screen and a high dynamic range to display radiographic data in the most meaningful way. High resolution and bright color monitors are also in use and add the capability to use color processing techniques to visualize the radiographic data as well as provide support for text and vector graphic color annotations on images. Ten bit monochrome monitors provide significantly more shades of gray to produce a smoother image and greater appearance of sharpness. 10 bits in a 2048 x 1536 layout is considered a 3 megapixel monitor.

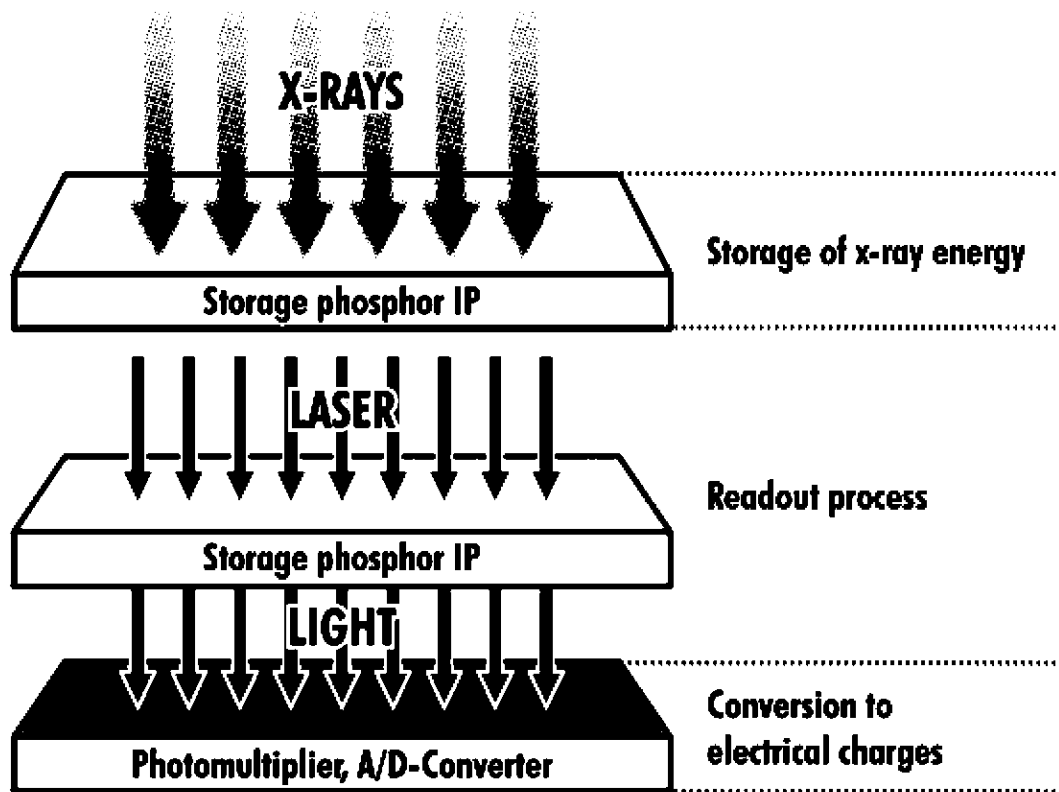
6.9.12.3 Storage Systems. Storage for the digital images varies from CDs, DVDs, and portable hard drives to intranet/network solutions. The media of choice should be carefully evaluated to maintain the images per the user requirement and/or their customer requirements. The format in which the images are to be archived for retrieval should also be decided with long term future parameters defined. Most digital image systems do not compress the images and original raw data may be saved in a proprietary format. The storage solution should also include a backup copy of digital data at all times.

6.9.12.4 Archival Systems. Archival and retrieval systems are gaining popularity for radiographers that generate large amounts of digital radiographs. These systems are usually comprised of a database and storage mechanism connected over a network. They make searching for an image easy through database commands at the workstation and deliver the image to the viewer upon request with the actual storage media used unknown at times to the radiographer so he or she need never worry about disk space, etc.

6.9.12.5 **DICONDE.** A standard for industrial digital radiography (and other digital images for nondestructive testing) is known as “DICONDE” - Digital Imaging and Communication in Nondestructive Evaluation, and is based upon the already well established DICOM protocol. This standard defines the manner in which image acquisition hardware, software, databases and archival system and printers SHOULD communicate. It also sets standards for data associated with a digital image and a universal file format and protocol so equipment by varying vendors will work with each other. Additional information on DICONDE can be found through ASTM and the Federal Working Group on Industrial Digital Radiography (FWG-IDR).

6.9.12.6 **Printing.** Digital images allow for the easy replication of hardcopy data either on film or paper. There are several digital film printers available at varying prices so you can produce a hardcopy film from a purely digital image. Some systems use chemicals similar to standard film processors, but more common are the systems which use either dye sublimation or thermal films for the hardcopy output of digital radiographs. Most digital radiographers forego the use of a film printer as in most cases, it is unnecessary in modern digital radiographic labs.

6.9.13 **Introduction to Computed Radiography.** Computed Radiography (CR) (photostimulable luminescence method) has emerged as a leading environmentally safe technology for recording a radiographic image similar to the ways that film radiography has been practiced for decades. CR offers many advantages over conventional film-based radiography. The most prominent advantages are the increase in productivity, ease of archiving and retrieving images, use of powerful image processing tools to qualitatively improve images, greater thickness latitude with same or better contrast sensitivity and in many applications, a lower X-ray dose to inspect the object. CR enhances productivity as image processing is accomplished in a very short time without the dependence of chemicals or water. CR can be described in simple terms as a two step radiographic imaging process; storage phosphor imaging plate is exposed to penetrating radiation and the luminescence from the plate’s photostimulated luminescent phosphor is detected, digitized, and presented via monitor or hard copy. Refer to [Figure 6-75](#).



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Figure 6-75. Example of Computed Radiography

6.9.13.1 CR-to-film comparison. CR is similar to film-based radiography as it utilizes the same radiation source but it differs in how the image is captured and processed. Rather than using conventional radiographic film, CR uses a flexible phosphor IP, which is exposed in the same manner as film but is processed using a CR reader or scanner. In simple terms, the reader uses a laser to convert the energy recorded in the IP phosphors into light, and the light output is converted into a digital image which can be evaluated using each manufacturer's unique CR software. Compared to conventional radiographic film, CR typically can produce improved contrast sensitivity as well as increase the image "latitude," being able to image a wider range of densities in one exposure as compared to film. However, conventional high resolution film is still considered to have superior spatial resolution than CR, primarily because the film contains silver halide grains on the order of 0.5-3.0 microns in diameter (ASTM E 1815-96 Class I), while state-of-the-art CR systems typically sample data at a resolution of 25 to 100 microns (pixel size). Although CR pixels are relatively larger than film grains, detection of fine defects (e.g., cracks, microporosity) is dependent on the combination of spatial resolution, contrast sensitivity, and signal-to-noise ratio (SNR).

6.9.13.2 CR Application. Most Department of Defense aerospace inspections are low energy (<160kV) applications that fall into two general categories: those that can be performed with low spatial resolution/low SNR (i.e. FOD, water, honeycomb), or those that require high spatial resolution/high SNR (i.e. airframe cracks, welds). Guidance for weld inspections using CR is published in TO 00-25-252. The following guidance is specifically related to low energy applications.

6.9.13.2.1 System Selection. Like film systems, CR systems can vary in capability. IPs can range from coarse grain to fine grain (like film), and IP readers can sample the data at low or high resolution. In addition, many other CR system variables, which will be discussed in later sections, can significantly influence the image quality. In most cases, a coarse or medium grain IP used with an IP reader with low sampling resolution can produce acceptable radiographs for low spatial resolution/low SNR applications. Conversely, a fine grain IP used with an IP reader with high sampling resolution may be required for high spatial resolution/high SNR applications.

6.9.13.2.2 Technique Development. For low spatial resolution/low SNR applications, technique development is fairly straightforward and often results in lower kV and/or shorter exposures than film. However, for high spatial resolution/high SNR applications, technique development must take into account other critical factors to ensure the required spatial resolution and SNR are achieved. As a result, CR techniques for these applications may or may not be similar to the equivalent film technique. Guidance for CR technique development and procedure conversion from film radiography is detailed in Appendix B.

6.9.13.2.2.1 Total Image Unsharpness. For applications with high spatial resolution requirements, total image unsharpness is critical to image quality. Total image unsharpness is influenced by geometric unsharpness as well as the characteristics of the IP and IP reader. Total image unsharpness must be validated by determining the visible wire pair using an unsharpness gauge (ASTM E2002) placed at the appropriate position in the object plane. This validation is typically performed by the technique developer and not required to be revalidated during the inspection.

6.9.13.2.2.2 Signal-to-Noise Ratio Requirements. For applications with high signal-to-noise ratio requirements, the exposure (mA x time) must be sufficient to achieve the required SNR. To verify adequate SNR, these techniques typically include a hole-type or wire type Image Quality Indicator (IQI) and may specify a minimum exposure. SNR measurement tools are not available on all CR systems, and CR systems that do have SNR measurement capability may not use the same algorithm to calculate the value. SNR tools for a particular CR system are validated against other methods for acceptance. An alternate method independent of system software tools is available using a test standard called the Equivalent Penetrator Sensitivity (EPS) standard to establish the required exposure and minimum PV (image intensity) for a given CR system. For USAF crack detection applications, the energy (kV) and minimum exposure (mA x time) is established by the technique developer for each approved CR system and provided in the inspection procedure. Typically for crack detection inspections, the technician may adjust the energy of the technique to achieve the minimum pixel value, but can only increase (not decrease) the exposure.

6.9.13.2.2.3 Scatter. CR is inherently more susceptible to the effects of scatter radiation than film due to the nature of IP materials and construction. However, most low energy applications are not significantly affected by secondary scatter radiation. The effects of scatter are typically evaluated during technique development, and if identified may be reduced or controlled through use of X-ray tube filtering, lead screens, or technique adjustments. Lead screens and lead backing can have the opposite effect on IPs from that of radiographic film. The additional generation of electrons may decrease the SNR of the CR image. Technique development should incorporate exposures with and without screens or lead backing to determine the best exposure parameters.

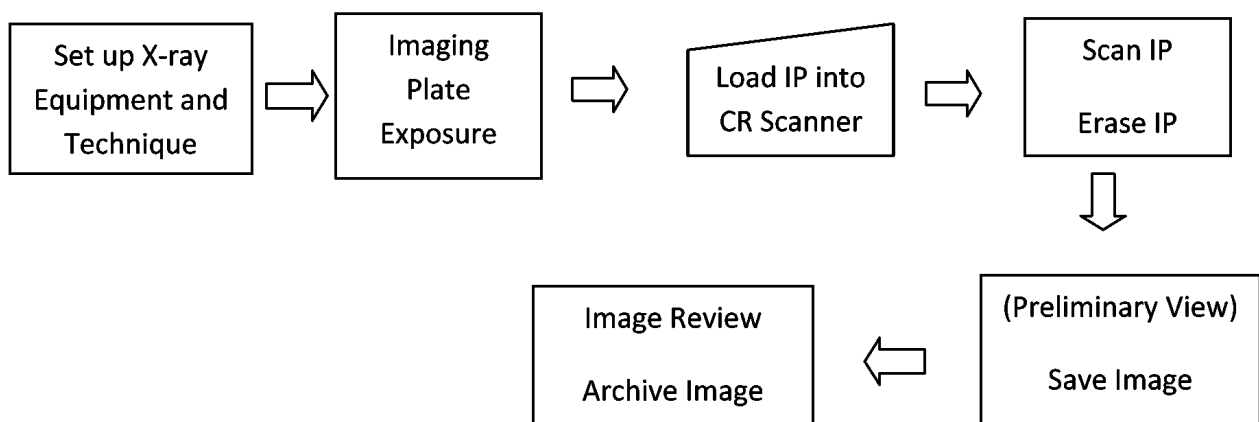
6.9.13.3 CR Process. The basic steps of the CR process include:

6.9.13.3.1 Step 1: Exposure of the object. Using the approved procedure, the test object is exposed to ionizing radiation, and an IP is exposed to the ionizing radiation and a latent image is created.

6.9.13.3.2 Step 2: Scanning of the IP. Depending on the CR system, the technician will enter pertinent information into the acquisition software before or after the scanning operation. The exposed IP is placed in the reader, often using a hard cassette specific to the system, and the IP is scanned with a laser (red) stimulating light causing photostimulable luminescence (PSL) “bluish” light to be released from the IP. This light is collected by optics and channeled to one or more photomultiplier tubes (PMT). The computer processes the information received and the software allows the viewing of the image data.

6.9.13.3.3 Step 3: Viewing/Post Processing. The image is displayed on a high resolution viewing monitor (typically monochrome), 3 megapixels or greater. Technicians evaluate the image according to the inspection procedures, and may add appropriate labels or annotations. During this step, contrast and brightness (also known as window and level), as well as magnification, are often adjusted by the technician. Unless authorized by technical data, post-processing filters shall not be used for final image evaluation.

6.9.13.3.4 Image Storage/Filing. The original data file, processed CR image (if required), and any annotations are saved and are retrievable based on archival requirements. Refer to [Figure 6-76](#).



Flowchart of CR Imaging

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Figure 6-76. Flowchart of CR Imaging

6.9.14 Computed Radiography System. The CR system is comprised of several components, each of which affects the inspection process. The primary components include imaging plates, CR reader, CR eraser (normally part of the reader), computer workstation, and a high resolution monitor.

6.9.14.1 Imaging Plates. A phosphor IP is a flexible two-dimensional area detector in which the latent image of the test part is stored after the test part is exposed to the penetrating radiation. The primary function of the IP is to release the radiation input signal containing object information into a corresponding optical signal while preserving the maximum amount of object information.

6.9.14.1.1 IP Construction.

6.9.14.1.1.1 IPs are made using the same type of polyester plastic substrate as modern X-ray films. They are produced in sizes similar to commonly available films. IPs typically include additional layers to control the emitted light and an outer coating to seal and protect the sensitive layer from moisture and abrasion. Unlike most X-ray films, IPs are all single-sided, and the thickness of the sensitive layer is greater than for film emulsion layers. Optimum imaging performance is obtained

when the sensitive layer faces the X-ray source. Severely degraded image quality and physically inverted images will result if IPs are mistakenly exposed “backwards”.

NOTE

IPs should be scanned as soon as possible after exposure. IPs can retain a latent image for several hours, although fidelity may degrade depending on environmental conditions. When no technical data exists, it is recommended to scan the IP within 60 minutes of exposure.

6.9.14.1.1.2 IPs contain a phosphor layer of fine-grained, barium fluorohalide crystals doped with a divalent europium (Eu²⁺). These IPs are coated on a polyester support and a polymer overcoat that provides protection against normal handling such as fingerprints and moisture. A polycarbonate backing layer provides anti-halation protection with flexibility and stability. When the IP is exposed to X-rays, electrons of the IP are excited to a higher energy level and are trapped in halide vacancies to form color centers. Holes created by the missing valence electrons cause Eu²⁺ to become Eu³⁺. These thin phosphors layer of fine-grained barium fluorohalide crystals captures the energy within the phosphor creating a latent image. The latent image will degrade over time but remains relatively stable for several hours.

6.9.14.1.1.3 IP Dynamic Range. The dynamic range of a phosphor IP can be significantly greater than that of radiographic film. This means a single exposure using a phosphor system may be able to replace a double load (or greater) film technique. The result of this phenomenon is the ability to successfully image parts with a wide range of subject contrast. Thick and thin sections, previously not viewable with film, can now be captured without multi-film or multi-exposure techniques. In some applications, this also allows for more flexibility in the mA x time combination, which allows for reductions in time of exposure. Reductions in exposure times improves productivity, reduces personnel exposure to radiation, and increases X-ray tube life. Further refinements in software allow for the use of a battery operated, pulse X-ray source, rather than a traditional X-ray tube.

6.9.14.1.2 IP Types. Many types of IPs are available. Like film, different IP types may have different grain sizes and different SNR performance. In general, fine grain IPs are preferred for high spatial resolution applications (e.g. detection of fine cracks, microporosity), and large grain IPs for low resolution applications (e.g. detection of foreign object debris, large defects). In many cases, one IP type may be suitable for multiple applications. Unlike film, IPs are not assigned a classification. Instead, CR “systems” can be classified (ASTM E2446) which includes the IP along with all other system components (i.e. scanner, scanner settings, X-ray tube, etc.). Manufacturers may specify IPs by type and/or performance (i.e. SNR, spatial resolution, etc.). Technical data should specify a specific IP and manufacturer along with all CR system components when used for critical applications.

6.9.14.1.3 IP Handling and Wear.

6.9.14.1.3.1 The normal wear-out mechanism for IPs is mechanical damage or abrasion. When the protective layer becomes scratched, the image quality is degraded. Thus, the life obtained varies dramatically with the care and cleanliness used in handling the IPs. In some applications, where the IPs are never directly handled and remain in rigid cassettes during storage and exposure, they can remain useful for many thousands of uses. However, some types of the high-resolution IPs needed in fine-detail aerospace inspections use thinner and softer protective layers that are more susceptible to physical damage, so extreme attention to handling conditions is needed to avoid premature scratching of these IPs. IPs should not be bent around a radius smaller than recommended by the manufacturer. Avoid handling the IP where creasing, scratching, or impact damage may occur. Creases or impact marks will create a permanent artifact on the IP rendering that section of the IP unsuitable for imaging.

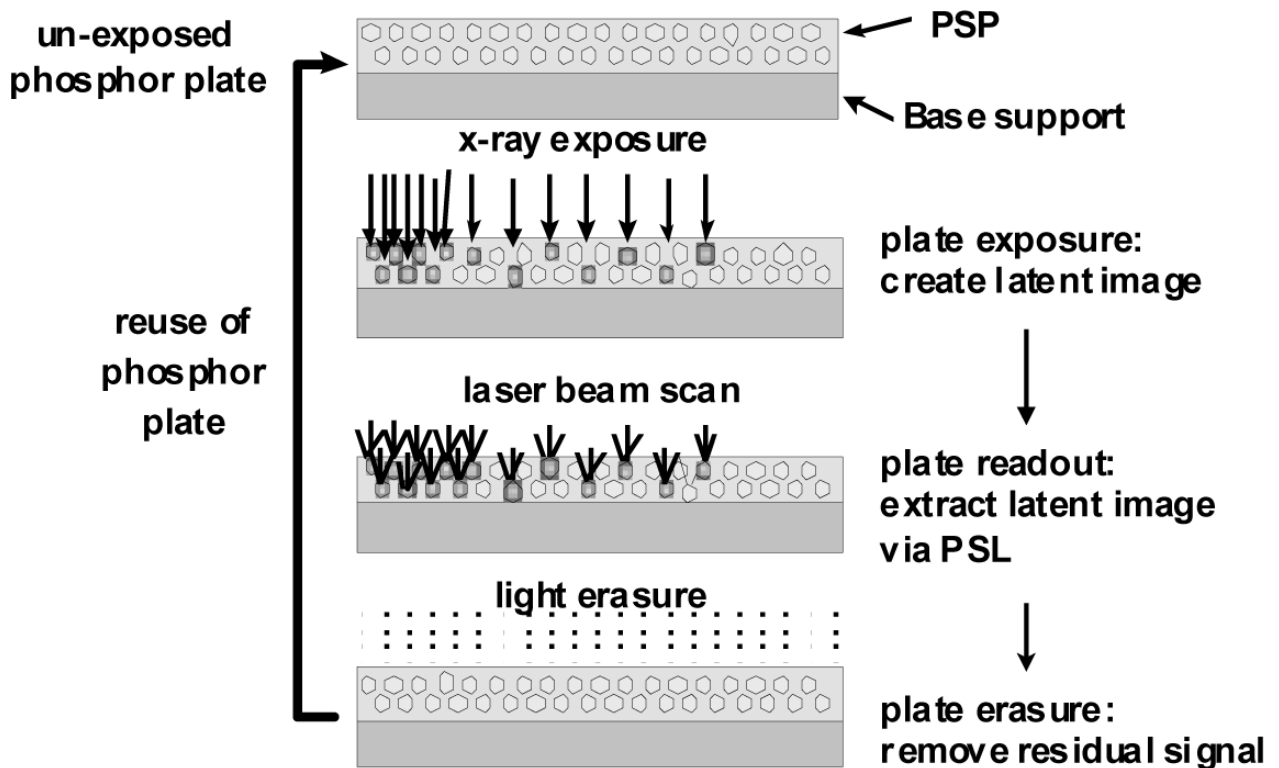
6.9.14.1.3.2 Particular care should be used to keep all cassettes, screens, and sleeves that come in contact with IPs free of dust and debris. IPs should be handled only by their edges to prevent skin oils and fingerprints from contacting the active surface. Minor scratching or contamination of the backing surface does not directly affect IP performance or image quality, but can cause the transport of dust and abrasives into cassettes, readers, or erasers. Technicians can use powder free vinyl/nitrile gloves to aid in keeping IPs clean. IPs should not be exposed to water or excess moisture. Any moisture should be immediately removed and dried with lint-free cloths. Breaks or delamination of the edge of an IP should be repaired with a clear lacquer or enamel paint applied with a small brush. Moisture intrusion on an IP will cause release of iodine, causing a yellow-brown stain on the IP resulting in a permanent artifact on the IP. Only IP manufacturer recommended cleaning solutions and procedures should be used on the IPs if removal of surface contaminants is required. Caution is required, since different manufacturers recommend differing and, sometimes, incompatible cleaning solutions and methods for their IPs.

6.9.14.1.4 **Cassettes For Exposure.** IPs can be exposed within typical flexible vinyl cassettes utilized in film radiography, or within a rigid cassette if provided by the manufacturer. When utilized with flexible cassettes IPs are typically flexible enough to wrap around a 1-inch diameter tube. For high signal-to-noise ratio exposures, an image of an embossed flexible cassette can occur on the resulting image. When this occurs, care should be taken to ensure that a suspect defect is not due to the cassette image. Depending on the CR reader, a rigid cassette may be necessary for processing.

6.9.14.1.5 **IP Shapes.** Depending on the type of CR reader, non-standard, custom IP shapes (i.e. other than standard size) may or may not be permissible. The manufacturer should specify if custom shapes can be handled by their reader. In some cases, a special cassette may be required for processing non-standard shapes.

6.9.14.1.5.1 **Cut IPs.** IPs are typically thin and can easily be cut with scissors or a sharp knife. Compromising the edge seal could make the IPs prone to moisture damage at the edges. Often, manufacturers may recommend cutting tools and materials for sealing IP edges after cutting. In these instances, IPs can be shaped to meet specific application and/or imaging needs. Handling and attention to detail is required to prevent damage to the IP and to prevent creation of artifacts that may interfere with interpretation. If custom shaped IPs are for routine use, the manufacturer may provide the custom shape IP if given dimensional details. This reduces the potential damage to the IP from cutting and edge sealing.

6.9.14.1.6 **IP Erasure.** Prior to each exposure, IPs must be erased. This is a separate step from the readout process, since readout alone does not remove all stored image information from a previously exposed IP. Erasure of IPs is accomplished through exposure to bright white light from fluorescent or halogen lamps, red light emitting diodes, violet light, or other means sufficient to release the stored energy either in the reader device (automatic) or in a separate eraser. Direct sunlight is also very effective at erasing IPs, but the protective coatings on certain older IPs can be damaged by its strong UV spectrum, so use of the manufacturer's erasure procedures and equipment should be followed. Refer to [Figure 6-77](#).



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Figure 6-77. Example of IP Erasure

6.9.14.1.7 Residual Images.

6.9.14.1.7.1 The sensitive layer of IPs consists of small crystals of a barium fluorobromide or barium fluorobromiodide material that absorbs energy from incident X-rays and stores that energy in excited states of the crystal structure. The CR crystals are, typically, much larger than the silver halide grains in industrial films. This allows for greater thickness of the sensitive layer and, consequently, improves X-ray absorption efficiency. The thickness of the sensitive layer and the crystal size can be tuned to adjust the speed and resolution of the IP. At the kV ranges used in many common inspections, the thickness and composition of the sensitive layer can make IPs somewhat more sensitive to scattered radiation than typical films; thus, in some inspections, a slightly lower kV setting, increased part-IP distance, or additional front screens are needed to compensate.

6.9.14.1.7.2 In all materials, the majority of electrons excited by X-rays decay back to normal energy levels in a prompt fashion, immediately releasing their energy back to the crystalline structure. But, the IP material also has metastable states that allow excited electrons to become “stuck” in a decay path that takes a longer time to relax. These states store the image information when the IP is exposed.

6.9.14.1.7.3 The image storage mechanism of the crystals does not wear out or become used up. Barring mechanical damage, IPs can be reused indefinitely for multiple exposures because of this inherent material property. However, there also can exist a small concentration of defect states caused by crystal imperfections. These can trap excited electrons and prevent them from finding the metastable states, thus, affecting the image storage efficiency. The defect trap states can persist for weeks, or even months, at room temperature.

6.9.14.1.7.4 In severe cases, the defect traps can cause residual or “ghost” images that can be very difficult to erase. Ghost equalization (e.g., exposing IPs to high doses followed by repeated erasure) is recommended by some IP manufacturers to recondition IPs with residual images, while others recommend exposing affected IPs to wide-spectrum ultraviolet light (e.g., direct sunlight). Any IPs that exhibit objectionable residual images cannot be used for inspection. Therefore, exposure techniques that subject IPs to extreme exposure contrasts should be avoided (e.g., very long exposures at low kV that are sometimes attempted when trying to achieve contrast in both thin and thick regions of small parts that do not fully cover the entire IP). Residual images can be reduced or eliminated with lead masking when the test article does not cover the entire imaging plate. If authorized for the application, pre-filters (at the X-ray tube) or screens (front/back of IP) may also help.

6.9.14.2 CR Reader/Eraser.

6.9.14.2.1 The reader/eraser is the component that will take an exposed IP, scan the IP using a laser light, capture the light emitted from the IPs, and provide the necessary information to the computer workstation. Following the exposure to the laser light, the eraser will expose the IP to white, or other color light causing the IP to be returned to a state for future use.

6.9.14.2.2 The characteristic time to naturally relax the excited metastable states is, typically, many hours at room temperature - allowing up to 24 hours in some applications between exposure and readout. However, if a red light photon is absorbed by an excited electron in a metastable state, it can then decay promptly through an alternate decay path, releasing its stored energy in the form of a blue light photon. This process is at the heart of CR: by “tickling” an electron that was previously excited by an absorbed X-ray with a red laser, it emits a blue light photon. This process is known as photostimulable luminescence, and a material with this characteristic is called a photostimulable phosphor (PSP). By measuring the amount of blue light emitted, the amount of absorbed X-ray dose is inferred, as shown in [Figure 6-78](#).

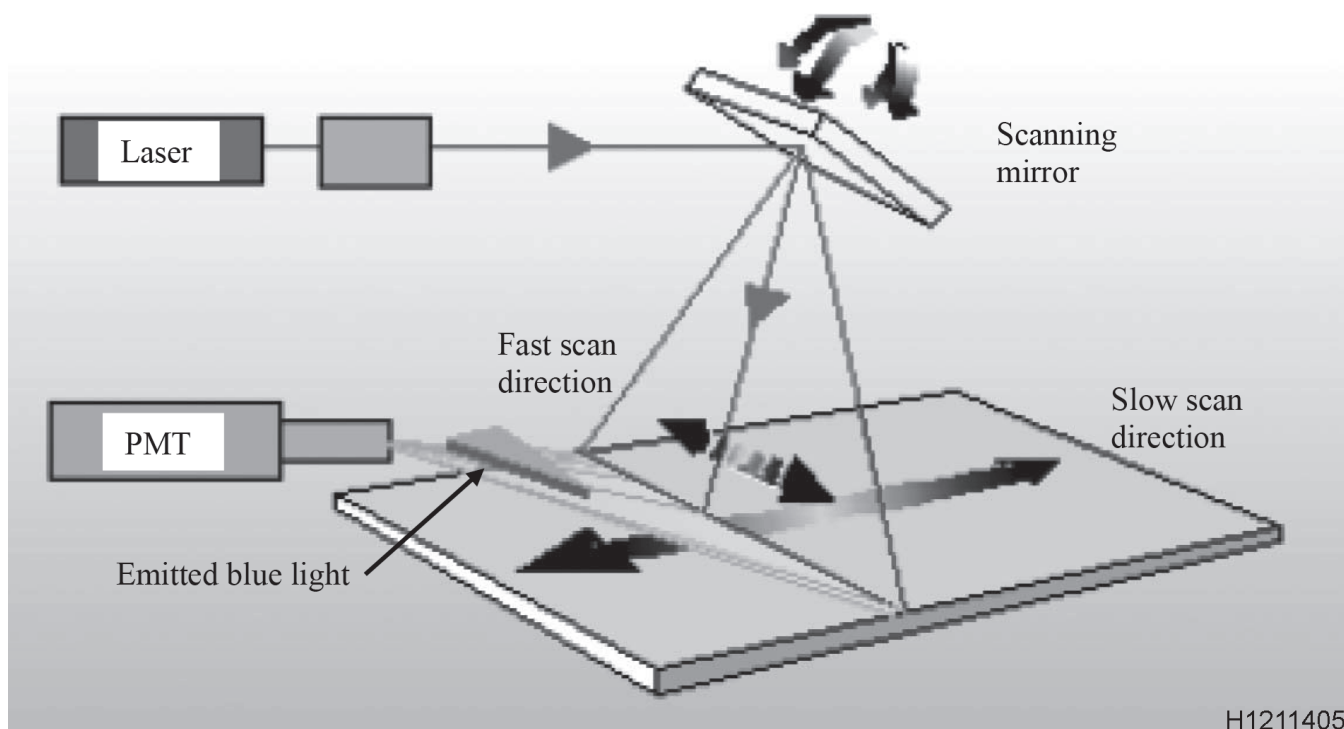


Figure 6-78. Flying Spot CR Reader

NOTE

The “Flying Spot” CR Reader sweeps a spot of red laser across the IP while the IP is being moved in the transverse direction. The blue light emitted from the IP is directed to a PMT. Each measurement sample (in time) yields a corresponding pixel (in space) for the resulting digital image.

6.9.14.2.3 The “flying spot” CR reader is not an imaging system like a camera or microscope, and the emitted blue light is not focused to an image receptor. Various readers use different methods to gather, or guide, the blue emission light into the PMT, but none focus light from points on the IP to an image receptor. Rather, the CR “image” is formed by sampling the PMT output in time and associating each measurement with the location of the red laser during that time interval. Referring again to [Figure 6-78](#), the PMT “views” a large area of the IP, so any and all blue light emitted can be gathered and measured.

6.9.14.2.3.1 Laser.

6.9.14.2.3.1.1 The red laser light is focused to a small, roughly circular area called the focal spot. The size of the spot varies between readers and influences the smallest image features that can possibly be spatially resolved by a particular reader. However, the actual image resolution limit is determined by the size of the blue emission spot, not the smaller red laser spot. The IP, ordinarily, contributes a significant degree of additional image unsharpness. The relatively large size of the CR crystals affects the absorption and scattering of visible light during the readout process. The larger crystals absorb less light and reduce optical losses, which allows for the increased thickness of the sensitive layer. However, they also have an increased tendency to scatter visible light, both the red excitation light and the blue emitted light. This material property causes some of the optical light to scatter sideways in the IP (i.e., perpendicular to the incident X-ray beam). Thus, the blue spot is larger than the red spot, causing additional blurring and unsharpness during the readout process

6.9.14.2.3.1.2 In addition to the actual focal spot size of the red laser and the lateral scattering of red and blue optical photons in the IP, a third factor also affects the area of the blue light “seen” by the PMT at any moment: the decay time of the excited metastable states. The emission of blue light is slightly delayed from the absorption of the red stimulation light and the typical delay time is a significant fraction of the PMT sampling time. Thus, the shape of the moving blue emission area exhibits a slight smearing, or “tail”, opposite the direction of motion. These three factors combine to determine an effective

readout spot size. Generally, none of these optical blurring factors is adjustable by users, so the limiting spatial resolution is fixed by the selection of reader model and IP type.

6.9.14.2.3.2 Spot Size.

6.9.14.2.3.2.1 The effective readout spot size is not inherently round, but tends to be elongated in the “fast scan” direction of the “flying spot” motion. However, the final spatial resolution is also affected by the sampling period. The effective spot moves during the sampling period, adding greater unsharpness to the image. Thus, the image resolution is often better in the “slow scan” direction than in the fast, requiring CR resolution testing to be performed in both vertical and horizontal image directions.

6.9.14.2.3.2.2 The time required to read out an entire IP is inversely proportional to the laser sweep speed and users must often wait while IPs are being read and erased, so the fastest useful speed is normally used. Thus, for a given laser sweep speed, the rate of sampling determines the size of the image pixels. The sweep speed is user-adjustable in some CR readers and most allow the sampling rate to be adjusted indirectly via a pixel sampling size adjustment. However, most CR image acquisition software programs provide a single adjustment that controls the laser speed, digitization rate, and the slow scan IP motion speed to achieve samples that are equally spaced in both directions. However, as explained above, the area represented by each sample period may not be square in shape and the actual spatial resolution may not be the same in both directions.

6.9.14.2.3.3 Sampling Resolution. The “best” sampling resolution for a particular IP/reader combination may not be obvious. The effective spot size is usually not a published specification, so technique developers often tend to try the smallest available spot size setting for a given reader. However, setting the sample resolution smaller than the effective readout spot size will not improve image resolution, but instead, can significantly degrade image quality because of increased measurement noise (i.e. decreased SNR). In principle, any type of IP can be scanned at any sample resolution; there is no such thing as a “50 micron IP”. However, scanning at a sampling resolution smaller than the effective laser spot size is counterproductive, and scanning at a coarser sample resolution will reduce the available image resolution (although perhaps yielding a faster readout cycle time). Thus, all settings affecting the sample resolution for a particular inspection should be controlled as key technique variables.

6.9.14.2.3.4 Laser Power. Some CR readers have an adjustment for laser power. Since the laser brightness is, ordinarily, insufficient to stimulate emission from all of the latent image states, the maximum power setting available usually results in optimum signal-to-noise performance. Exceptions can occur when high power settings degrade the laser focus, so guidance from the reader manufacturer should be followed.

6.9.14.2.3.5 PMT Gain. Most CR readers have an adjustable gain setting that affects the amount of electric current produced by a given amount of light. If the gain is too low, the dynamic range and stability of the PMT are affected. However, a too high gain setting cannot compensate for information loss in noisy low dose images, as it will merely amplify the contrast information and the background signal alike. Thus, the PMT gain setting (sometimes called PMT voltage) should be as low as possible without affecting stable operation of the PMT. The PMT current is amplified prior to digitization, but the conversion from PMT output to the displayed result is not always linear (see LUT, [Paragraph 6.9.19.2](#)). The set of digitized data measurements is stored as an array of digital data in a computer file.

6.9.14.2.3.6 Processing Cassettes. Depending on the CR system, processing cassettes may or may not be required.

6.9.14.2.3.7 Operations. Although all readers operate similarly by transporting an IP past a scanning laser, specific features of readers can be drastically different. Some features to be aware of include:

- a. IP handling. IP wear can be significantly different based on the reader design. Some drum type readers are more prone to score the surface of the IP as it is moved across the surface of the drum. This primarily occurs on the non-imaging side of the IP, but over time, can affect image quality. Many other systems with internal rollers may cause minor IP damage, but most newer systems are designed to avoid abrasion of the IP surface and/or incorporate roller design that are very gentle on the IP surface. Some drum-type systems may also allow use of a “plate protector”, similar to a flexible cassette in appearance, which prevents abrasion on the IP surface as it is fed into the scanner.
- b. Custom IP Handling. A common user requirement for airframe inspection is the ability to process custom shaped IPs. This is necessary in many cases due to access limitations (e.g. nearby structural interferences, etc.). Some hard cassette systems will only process rectangular IPs in standard sizes (i.e. 5 x 7, 8 x 10, 14 x 17 inches). Other systems can handle relatively simple custom shapes (e.g. hard cassette systems with custom templates; drum readers), and other sys-

tems can handle nearly any shape IP by employing unique features (e.g. glass cassette that remains closed during scanning; use of a sticky “carrier” plate that the custom IP can be laid on for transport through the reader). Likewise, for the less common requirement for the capability to process IPs of non-standard lengths (i.e. >17 inches), only a few reader models can accommodate.

- c. Artifacts. Dust, lint, and debris can be trapped within a cassette or on an IP, so care must be taken to keep these areas clean. However, some reader designs are more prone to introducing contaminants that cause these artifacts, possibly due to location of internal optics, type of openings for transporting IPs, and/or airflow within the reader. Though not a significant concern for all applications, these contaminants appear as white artifacts and can be misinterpreted as defects (e.g. tungsten inclusions in welds). Several methods are used to confirm an indication from an imaged artifact. These include rotating the IP to a different orientation, exposing the area of interest on a different area of the IP, or using another IP. Cleaning the IP should be performed prior to additional exposures.
- d. Removing IPs from flexible cassettes and loading into the CR scanner shall be performed in subdued, indirect lighting to avoid image loss from the IP. Exposed IPs should remain in the cassette until processed through the CR reader and replaced in the cassette after processing to minimize damage and/or foreign material accumulation on the IP. Lighting in the area of the scanner should be incandescent or LED if used while loading or scanning IPs.

6.9.14.3 Computer Workstation. The workstation typically controls both the acquisition and viewing of the CR image.

6.9.14.3.1 Acquisition Interface. The acquisition interface allows the user to select pertinent reader settings prior to scanning the IP. The interface controls may be on the reader and/or within the computer workstation, depending on the CR system manufacturer and model. Selectable reader settings typically include sampling resolution, laser power and PMT gain (or equivalent). In some cases, one or more of these parameters is fixed. Acquisition software also typically provides data fields for inspection and technique information. In most systems, all image processing functions are controlled after the image is displayed, but in some cases the acquisition software may require selecting some image processing presets. Some software may also have a selection for saving the image file type. DICONDE is the preferred file type for saving data.

6.9.14.3.2 Image Viewing Interface. Once the reader has scanned the IP and displayed the image on the viewing monitor, controls are provided for viewing and post-processing the image such that the user can interpret the radiograph per specified procedures. These controls typically include window/level, magnification, image filters, and various other tools. Use of these controls may be regulated by the specific inspection procedure.

6.9.14.3.3 Viewing Monitor. CR systems may have one or multiple monitors. In all cases, the monitor for viewing the CR image must be a high resolution monitor containing 3 or 5 million pixels (i.e. 3MP or 5MP). In most cases, the high resolution monitor is monochrome (i.e. black and white), but may be color. When a second monitor is employed, it is typically a low resolution monitor strictly for displaying the user interface. This low resolution monitor SHALL NOT be used to interpret CR images. To extend the life of the monitor, enable automatic power saving feature, use a screen saver, or turn the monitor off when not used for extended time. Most monitors have built in luminance measurement and should notify the user if it falls below recommended value. Ensure the monitor is set for viewing images, such as high luminance mode. Monitors require periodic process control evaluation. Any distortion of the image should be investigated and the monitor repaired or replaced.

6.9.15 Display Conversion.

6.9.15.1 Display conversion is the process of changing digital bits to a visible representation. Note that the term “pixel”, or “picture element”, is used both to describe the area corresponding to a digital measurement sample, as well as referring to an individual discrete picture element on a computer monitor.

6.9.15.2 The format of the underlying digital data is determined by the CR reader and does not directly match the characteristics of the monitors used to display the radiographic image. Thus, all image viewing software provides for certain key functions (spatial re-sampling and gray mapping) and most platforms also provide the ability to perform additional optional functions (filtering, analysis, and annotation). Some platforms also allow a conversion of the data from the native format output by particular readers or to perform response normalization.

6.9.15.3 The various steps of the display conversion process can be separated into two groups: pre-processing (which occurs before the image data are stored in a computer data file) and post-processing, (which occurs afterward). Pre-processing steps are ordinarily irreversible, while post-processing can be reversed or modified by reverting to the stored data.

- a. Pre-processing, typically, occurs either in the CR reader device or by the acquisition software immediately after image data are transferred to the controlling computer.
- b. Post-processing usually occurs in real-time and is performed by the image display software on the image review computer, acting on a copy of the image data in volatile storage.

6.9.16 Point-to-Point Pre-Processing.

6.9.16.1 One common type of pre-processing is used to convert every pixel in a CR data image to an equivalent value in an alternate format. Various CR readers provide digitized data in different native output types, depending on the number of bits per pixel produced. Most common are 12-bit logarithmic, 12-bit square-root encoded, and 16-bit linear. The logarithmic data format allows a wide dynamic range of values and produces a display that resembles film radiographs in appearance. Square-root encoding produces a constant signal-to-noise ratio across the digitized output range. Linear data formats require more bits to span a similar dynamic range, but can be easier to interpret and ease exposure adjustments. Software systems that support multiple readers often allow changing data from all readers to a common default format, for instance, by switching data from native 12-bit logarithmic readers to 16-bit linear format. When selected, this conversion happens prior to image file storage, automatically substituting each distinct possible input value into its corresponding output value. This conversion ordinarily occurs with, essentially, no loss of information, but significantly alters the appearance of displayed images. When this type of processing is an option in a software package, it must be controlled as a key technique variable.

6.9.16.2 Another common type of pre-processing is normalization, sometimes called calibration. In most CR readers, the natural efficiency of the blue light gathering varies from side to side across the reader in the fast scan direction. Poorly normalized CR images will exhibit vertical stripes or bands, so most CR systems allow measurement of the left-to-right response variation, and then allow for each pixel from a given image column to be divided by the relative response, eliminating the vertical artifacts. This type of pre-processing also ordinarily results in no significant information loss.

6.9.17 Image Filtering.

6.9.17.1 Most software packages provide a number of digital processing filters that can be used to transform the data. Image filters, usually, process multiple data points to create a single output point, but without changing the number of image pixels. Thus, filter operations do not change the number of pixels in an image or the total amount of data being displayed.

6.9.17.2 Two basic types of filters are possible: temporal and spatial. In temporal filters, a single pixel location is repeatedly sampled and the samples are added to improve the signal-to-noise of the resulting image. Temporal filtering is, usually, a preprocessing operation; however, since an IP is ordinarily read only once before erasure, temporal averaging is rare in CR. Spatial filters are, typically, applied after the image data is stored as a post-processing step. In spatial filtering, multiple data points from nearby neighbors are added. If they are added equally, the effect is to average, or “smooth”, the data. If some of the neighbors are subtracted, the effect is to enhance edges, or “sharpen”, the data. Non-linear filtering is also possible; for example, the common median filter outputs the median of the image data values in the nearby neighborhood of each pixel. (More information on types of spatial filters is presented in [Paragraph 6.9.17.7](#)).

6.9.17.3 Because spatial filters alter pixels based on their neighboring pixels into one, the order in which filters are applied is critical. For instance, the results of first smoothing, then sharpening, are noticeably different from first sharpening, then smoothing. Thus, if multiple filters are applied, the order of filtration must be controlled.

6.9.17.4 Filtering can emphasize some parts of the available information, but at the cost of making other information more difficult to visualize. Developing appropriate filtering often requires a detailed understanding of the data and noise characteristics. Demonstrating that a filtering process reliably enhances interpretation without masking otherwise-detectable indications can require significant rigor.

6.9.17.5 Note that some software programs apply proprietary filters as a pre-processing step when various material/inspection combinations are selected and do not retain the original data. These filters should be implemented only with caution, as this type of filtering is irreversible, and provides an opportunity for reducing the visibility of defect indications if improperly applied.

6.9.17.6 The use of filtration for final interpretation of CR images for challenging aerospace applications is not recommended. Any preliminary interpretation using filtration shall be validated with the unfiltered image to ensure the filtration did not create or eliminate indications of interest. In any event, if filtering is employed, two controls should be applied:

- a. The original unfiltered data should be retained as part of the inspection archive.
- b. The exact sequence of filter steps should be specified in the inspection technique.

6.9.17.7 Digital Radiographic Image Analysis.

6.9.17.7.1 Processing and Analysis. Image processing and analysis or enhancing can affect the quality of a digital image. It can make digital images easier to interpret than traditional film-only based radiographic methods, or it could “hide” relevant indications. Use of image processing should be evaluated carefully before it is incorporated into an inspection procedure

6.9.17.7.1.1 Group Processing Techniques. Group processing of pixels is a mathematical process that changes a pixel's value based on the values of neighboring pixels. This mathematical process is known as a convolution, and the application of the process on an image is called applying a convolution filter to the image. Some examples of convolution filters are noise filtering, image sharpening, image blurring, and edge enhancement. There are many more filters used in digital imaging, but these are the most commonly accepted in digital radiography.

6.9.17.7.1.1.1 Noise Filtering. Random patterns of noise in an image can be removed to some degree by applying a noise removing convolution filter. The most common of these in use for digital radiography is known as a “median filter.” The median filter works by examining the pixels surrounding a given pixel, and sorting them in order of magnitude. The median value is then used to replace the pixel being examined. This tends to remove small noise spikes in an image while leaving the information containing portion of an image relatively untouched.

6.9.17.7.1.1.2 Image Sharpening. Image sharpening improves the sharpness of an image and is usually executed by the means of a high pass or related convolution filter. The high pass filter accentuates high spatial frequency changes in an image making the image sharper. This filter type is used frequently in digital radiography because it enhances areas of high contrast change making indication more easily seen and measured.

6.9.17.7.1.1.3 Image Blurring. Image blurring can help the viewing of noisy images by blending the noise into the background image when a median filter either introduces too many artifacts, or just unable to eliminate the type of noise in the image. Frequently, a blurred image is processed again by a sharpening filter to help create an “edge enhancement” effect. Blurring is most frequently executed through the use of a low pass filter which attenuates areas of high contrast change.

6.9.17.7.1.1.4 Edge Enhancement. Edge enhancement convolution filters help define the edges of contrast change within an image, making them easier to see. Edge enhancement filters can frequently change the size of an indication (usually making it appear slightly larger than it actually is) so caution SHALL be exercised when used.

6.9.17.7.1.2 Frame Processing Techniques. Frame processing techniques manipulate the image by changing the locations of pixels within an image. “Image rotation” and “image scaling” are common frame processing techniques.

6.9.17.7.1.2.1 Image Rotation. Sometimes a digital image is not in the orientation we would like to view it, so the image MAY be rotated to adjust it. Rotation of digital images SHOULD be performed only in 90° increments to avoid having to produce interpolated or extrapolated pixel values for areas of the image that do not fall exactly on a pixel boundary.

6.9.17.7.1.2.2 Image Scaling. Image scaling is the magnification or reduction of apparent image size on a monitor or printing device. In digital radiography it is common to not use interpolation or extrapolation methods that alter the actual pixels of the image except to make them either smaller or larger. Other scaling methods try to guess at what a pixel value SHOULD be based on the pixels surrounding it during magnification routines.

6.9.17.7.1.2.3 Other Frame Processing Techniques. Other frame processing techniques include transforms, which map image data into another space or domain and operate on it there, frequently with a convolution filter or another frame processing technique. Examples include Fourier transforms and YCC photo CD color space conversions. Some compression algorithms rely on domain transforms as well.

6.9.18 Spatial Re-Sampling.

6.9.18.1 The actual size of pixels on a LCD monitor is, typically, in the range of 0.150 to 0.300 mm, which is usually larger than the CR sample size corresponding to each data pixel (common sizes include 0.050 mm and 0.100 mm, i.e., 50 and 100

micron). The number of pixels in a digital CR image is, therefore, usually greater than the number available on the monitor used to view the images. Ordinarily, there is neither a 1-to-1 correspondence between a single data pixel and a single monitor pixel, nor does the size of the image displayed on the monitor match the actual size of the latent image that was captured on the IP.

6.9.18.2 The resampling adjustments that determine which data pixels are displayed in each monitor pixel are commonly called pan and zoom. Zoom refers to adjusting the apparent magnification, or the number of CR data pixels that are displayed in a single monitor pixel. When the magnification is high enough that the full CR image corresponds to more pixels than are available on the monitor, pan refers to adjusting which region of the CR data are displayed and which portions are cropped. These adjustments are normally applied as a post-processing step and can be changed as needed to examine all regions of interest in a digital image.

6.9.18.3 There are three ways to characterize zoom: distance-to-distance, pixel-to-pixel, and image-to-image. In distance-to-distance, 1 cm on the IP corresponds to a variable number of cm on the monitor screen, independent of the CR sample size or monitor pixel size. In pixel-to-pixel, 1 CR data pixel corresponds to a variable number of pixels on the monitor. In image-to-image, the CR image is zoomed to fit a variable fraction of the monitor image window size. Different software programs use different names for these modes and few offer all three modes, so training with a particular package may be required to discern them.

6.9.18.4 The zoom factor is often expressed as either a ratio, a value, or as a percentage. For example, a magnification ratio of 8:1 also can be expressed as a magnification value or factor of 8, 8.0, or 800%. The simplest magnification is pixel-to-pixel mode at 1.0 or 100%, or 1:1, where each monitor pixel is used to display a single corresponding CR data pixel. Although this mode cannot remove aliasing that may be present in the underlying digital image, the 1-to-1 mode does not add sampling or aliasing artifacts and provides the optimum display fidelity. Other integer values of pixel-to-pixel zoom are free of resampling artifacts, but zooming out to display more image pixels than monitor pixels still results in a possible loss of inspection information, unless the display area is carefully panned to examine all regions of interest.

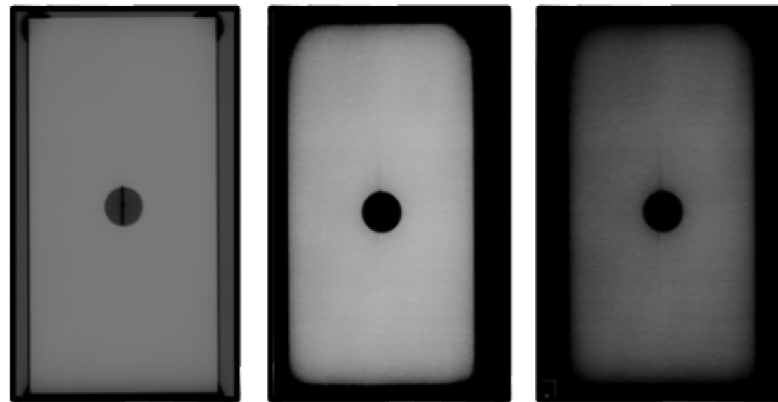
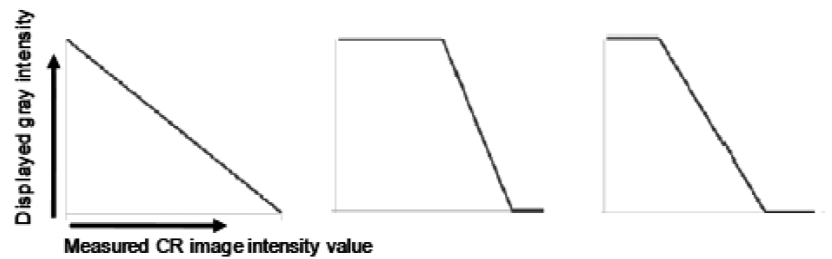
6.9.18.5 All other zoom types and levels require either sub-sampling, averaging, interpolation, or replication of the CR data pixels before a derived data value can be calculated and may result in both artifacts and a loss of inspection information. Resampling artifacts, typically, appear as periodic diagonal or crosshatched bands or stripes in displayed images, but can be eliminated by choosing a pixel-to-pixel zoom mode. Again, different software programs use different format conventions for the zoom factor values and few offer all three modes, so training with a particular package may be required to determine optimum display procedures.

6.9.19 Gray Mapping.

6.9.19.1 Typically, the digital radiograph data has between 12 (2^{12} or 4096 gray levels) and 16 bits (2^{16} or 65536 gray levels) of contrast information available. Human eyes cannot distinguish even 4096 distinct gray levels, but only somewhere between 7 and 10 bits (i.e., 128 to 1024 levels) of gray. Thus, not all of the contrast information can be viewed at any given time. The mapping adjustments must be adjusted in discrete steps. Gray mapping is ordinarily a post-processing step and, thus, is adjustable and does not result in irreversible information loss.

6.9.19.2 Gray mapping is implemented using a Look-Up Table (LUT). This is simply a table or list of output gray levels for each possible input level. Since grays are a subset of the color display spectrum, this method can be used to create color maps as well. These maps are normally called "pseudo-color", or false color maps, and are commonly used in the display of data from other NDT modalities such as ultrasound or eddy current testing. Pseudo-color displays do not provide a uniform perception of contrast across the range of displayed values, but tend to emphasize contrast in the data regions that are mapped into transition regions between bands of differing hue. Because of the smaller monitor pixels and calibration features available in gray-only monitor, grays also can be viewed on color monitors, and it is often desirable to make digital X-ray data appear film-like, gray mapping is usually preferred for the display of digital radiographs.

6.9.19.3 The LUT is typically calculated using a ramp function. A ramp function specifies the mathematical formula for changing input digital values (corresponding to measurements of X-ray absorption) into output gray values (for display on a monitor, film, or hard-copy print). The ramp function has only a few parameters that can be adjusted. The most common ramp function is linear, where the shade of displayed gray is varied so that the optical light intensity varies in direct proportion to the digital data values, as shown in [Figure 6-79](#). Only two parameters describing the slope and midpoint of the middle portion are required to specify the ramp function.



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Figure 6-79. Conversion Linear Ramp Function

6.9.19.4 Thus, the absorbed X-ray intensity at a small region on the IP is directly translated into optical light intensity at a monitor pixel for viewing. Terms like window and level, center and width, or contrast and brightness are used to describe the mapping of data values into grayscale brightness, depending on the software used to display the radiographs. CR images, typically, must be viewed using multiple sets of window/level settings to examine all part thickness ranges at full contrast sensitivity.

6.9.19.5 Non-linear grayscale ramp functions are also available in some software packages. Logarithmic ramp functions can mimic the optical density response of X-ray film from 16-bit linear image data and display a wide latitude of part thicknesses in a single ramp adjustment. “S-shaped” sigmoid ramps also increase latitude while keeping high contrast for mid-range data.

6.9.19.6 Because the display of the CR images depends upon features that vary between different software packages, the package and version used for inspections should be specified in the technique and documented as part of the inspection record. Particularly if various possible defect indications require differing gray mappings for optimum display, appropriate ranges for these ramp parameters can be specified in the technique.

6.9.19.7 Procedures shall state a minimum and maximum PV (gray level) range for a given exposure and/or region of interest. For example, an acceptable range for a 16 bit image is from 6500 to 62,000. This only ensures that the image is not extremely over or under exposed. A good indicator of adequate exposure dose is when the PVs for the area of interest are in the mid to high-range of the system. When PVs of the area of interest are near the high or low end of the acceptable range, the image may be over or under exposed.

6.9.19.8 These adjustments allow detailed examination at full contrast resolution across a wider latitude of part thicknesses than could be viewed in a single image. The adjustments can have a strong impact on the visibility of low-contrast defect indications. CR inspection images often must be examined using multiple sets of window and level adjustments to verify

IQI sensitivity and span the required range of part thicknesses. If the CR data are to be archived after inspection, the ramp function type and the parameters used for interpretation of defect indications in displayed images should be recorded as part of the inspection records. Refer to [Figure 6-80](#).

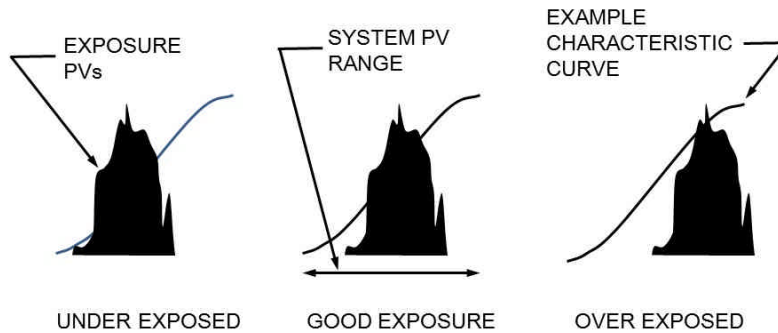


Figure 6-80. IP Exposure and Pixel Value Range

6.9.19.9 Many software programs also provide an unrelated type of gray mapping called “histogram equalization”. This type of gray mapping is based on the actual distribution of intensity values within the specific digital image. By ranking the intensity distribution in the image according to the number of pixels that exhibit the same intensity, the equalization process results in a displayed image where the same number of pixels are assigned to each gray level displayed. This is not a spatial or temporal filter and does not have a simple quantitative function between input data values and output gray levels, but does provide a method to display the entire dynamic range of data in a single view.

6.9.20 Adding Annotations and Analysis.

6.9.20.1 A number of graphical tools are available in most image review software packages, including measurement tools and annotation tools. These allow the user to add markings to the displayed image showing geometrical measurements (e.g., distances, angles, etc.) or to add captions and arrows pointing to features of interest. These tools can be useful to document inspection results. The majority of software programs for CR add these elements to a displayed view in real-time as a post-processing operation and allow for their removal or repositioning, thus, are safe to use as needed.

6.9.20.2 The annotated displays can be archived in two ways. Most software packages can store a “recipe” for the post-processing steps (including annotation and analysis) and, thus, recreate a display for documentation or reporting purposes. However, these recipes may not easily translate from one software package to another and are, typically, unavailable to users of generic image display programs on common computers. Thus, most software programs also provide the ability to “export” displayed views, typically, by writing the 8-bit pixel values displayed on the monitor into a computer file using a common picture file format. In this case, the exported images usually have any annotations permanently added to the view and the wider 12-bit or 16-bit dynamic range of the original imaging data is lost. These exported views are useful for documentation and reporting and can be inserted as figures into word-processing and presentation files for sharing with non-specialists, but often are not sufficient for archiving of inspection results.

6.9.20.3 Geometric measuring tools are useful when evaluating indications for size such as porosity, voids, or indication length. Software measuring tools may include length, diameter, area, or angle. When utilizing measurement tools, it is necessary to calibrate the imaging software using a known dimension on the image. These measurement tools count pixels and

convert the number of pixels to a dimensional display in the imaging software. Calibration is normally performed in one direction. Accuracy should be confirmed in the other direction, i.e. calibrated in horizontal direction, confirmed in vertical direction. Ideally, the known dimensions or comparator scale should be near the central beam, placed directly on the IP or cassette to minimize geometric magnification. In practice, a sphere with known dimension placed on the part is a calibration reference. Other references may include known dimensions of a part (wall thickness, diameter), IQI dimension (if no more than 2.5 degrees from the central beam), or a known dimensioned object such as a radiopaque ruler. Plate type references, such as a hole-type IQIs must be parallel to the IP. References from plate like objects or drilled holes may be inaccurate due to geometric magnification and edge distortion. Magnification of the image when calibrating must include the object within the viewing area. Image software measurement calibration must be performed for each individual image or exposure.

6.9.20.4 CR image analysis is similar to radiographic film analysis when inspecting for FOD, water, or discontinuities. CR systems provide various software features to assist the technician in image interpretation. Other than contrast, brightness and magnification, filters are available for image enhancement. Filters should only be used to aid in locating potential discontinuities or discrimination of features. Improper use or sequence of applying filters can lead to significant modification of original data with potential loss of discontinuity images. Unless authorized by specific technical data, filters shall not be used for final interpretation of images. Pixel value ranges of IQIs and areas of interest, when specified, should only be evaluated on unfiltered or raw data.

6.9.21 Viewing Room Ambient Light. Subdued, indirect lighting in the viewing and/or IP scanning room is preferred rather than total darkness. Preferred lighting in the viewing room should be indirect incandescent or LED. Fluorescent lighting is not recommended. Background illumination lighting shall be arranged such that light reflections do not interfere with review of the images. Background ambient light levels should not exceed 30 lux (3fc); light levels shall be measured at the monitor surface, with the monitor off. The interpreter should wait sufficient time, after entering the viewing area, before interpreting images.

6.9.22 Process Controls. A variety of process controls are required on CR systems to ensure the systems are operating at the required level of performance. The intervals of the test and the method of performing process controls are published in TO 33B-1-2.

- a. Monitor test. The Society of Motion Pictures and Television Engineers (SMPTE) have produced a standard SMPTE RP-133 that contains a standard electronic image for evaluating most of these display parameters. Process control tests require visual evaluation of the pattern to evaluate the contrast, brightness, spatial resolution, and overall performance of the monitor.
- b. Imaging Plates Artifact Documentation. The artifact test evaluates the CR image for non-relevant indications inherent to the imaging plate. (i.e. scratches, nicks, etc.)
- c. Reader System Evaluation. There are several test accomplished using the USAF CR Process Control Standard (CRPCS) or the NAVAIR Phantom.
 - (1) Contrast Sensitivity - evaluate the ability of the CR system to resolve low contrast features.
 - (2) Spatial Resolution - evaluates the ability of system to resolve small details or features.
 - (3) Geometric Distortion - evaluates the image for overall distortion.
 - (4) Laser Jitter - evaluates the image to determine if a lack of smooth movement of the imaging plate and laser scanning device occurs.
 - (5) Slippage - evaluates the image to determine if lines of data in the image are uniformly spaced.
 - (6) Scan Line Dropout - evaluates the image for lucent or bright white straight lines oriented in the long or "slow scan" direction.
 - (7) Blooming or Flare - evaluates the image for evidence of overrun or streaking in areas with high density contrast.
 - (8) Shading - evaluates the image for non-uniform intensity across the scanning width, evident as either as a gradual change in the shade of gray in the "scan" direction or as "bands" of shading in the "feed" directions.

(9) Residual image - evaluates the erasure performance to ensure a residual image does not remain on the IP which can affect interpretation of future images.

- d. For AF crack detection and welder certification applications, an additional check is required to measure signal-to-noise (SNR) performance. However, SNR tests are currently restricted to only a few CR systems because of availability of SNR measurement tools, differences in SNR algorithms, and limited test data to verify the required SNR criteria for a given system. An alternate method uses an Equivalent Penetrant Sensitivity (EPS) standard based on ASTM E746 that visually measures a parameter analogous to signal-to-noise ratio, but is independent of CR system software.

6.9.23 Tools Used in Image Interpretation. Many of the following terms may vary by manufacturer.

- a. Windowing and Leveling - Window (contrast) and level (brightness) controls are commonly used to adjust the image to allow the appropriate contrast sensitivity in the area of interest. (e.g. thick and thin areas in same image may require different window and level settings to interpret properly, although a large window setting may display the entire image with decreased contrast.)
- b. Area Adjust - Software automatically adjusts window and level of entire image or region based on minimum and maximum brightness levels within a region.
- c. Pan/Scroll - Allows the user to move the image in any direction in the image viewing area.
- d. Magnification/Zoom - Zoom refers to adjusting the apparent magnification, or the number of CR data pixels that are displayed in a single monitor pixel. Technical data may limit the magnification level for image interpretation.
- e. Area Zoom - Allows user to select a portion of the image for magnification.
- f. Calibrate - Allows for calibration against a known dimension within the image.
- g. Ruler - Allows user to make length measurements.
- h. Region of Interest (ROI) - a selection of the image in which measurements are being made (e.g. pixel statistics, signal-to-noise ratio, etc.).

6.9.24 Digital Image, Data Archival and Retention.

NOTE

DICONDE is the preferred format for saving digital images.

6.9.24.1 Image processing and resulting data files vary among manufacturers and data files may be stored in proprietary format only readable by the manufacturer's software. A preferred method of data file format processing and storage, especially when multiple systems are used, is the DICONDE format. With some software applications, the image storage format is selected prior to scanning the IP. Converting from proprietary format to DICONDE and vice versa is generally not possible. Refer to applicable technical data for image storage requirements.

6.9.24.2 CR system manufactures typically provide shared software or light simple function software so that the images can be shared with colleagues and customers that require the ability to evaluate the raw images. Exporting and or saving the raw image to an accepted digital format such as tiff, JPG, and or bitmap along with many other formats is a typical function that requires standardization by the user and/or their customer requirements.

CHAPTER 7 LASER SHEAROGRAPHY

SECTION I LASER SHEAROGRAPHY (ST) INSPECTION METHOD

7.1 GENERAL CAPABILITIES OF LASER SHEAROGRAPHY INSPECTION.

7.1.1 Introduction to Laser Shearography Inspection.

7.1.1.1 Shearography interferometry nondestructive inspection (NDI) use laser-based imaging interferometers to detect, measure and analyze surface and subsurface anomalies in materials or structures by imaging submicroscopic changes to a test part surface when an appropriate stress is applied.

7.1.1.2 Shearography NDI methods are mature and effective solutions for a wide range of aerospace NDI applications including composite aircraft panels, aircraft tires, control surfaces, metal honeycomb or foam core panels with metal or composite face sheets, elastomer or cork bonds, composite over-wrap pressure vessels (COPVs), spray on foam insulation (SOFI) and solid composite laminates.

7.1.2 Background of Laser Shearography Inspection.

7.1.2.1 The principles of holography were described by Gabor in the late 1940s but it was only with the development of the laser in the 1960s that a light source with sufficient power and coherence became available for practical applications of holography. During the 1960s and 1970s holographic interferometry, based on work by Stetson was developed for NDI purposes.

7.1.2.2 The electronic image shearing interferometer was pioneered in the early 1980s by three researchers, Dr. John Butters at Loughborough University in the United Kingdom, Dr. S. Nakadate in Japan and Dr. Mike Hung at Oakland University in the USA. The commercial development of the shearography camera as a tool for nondestructive testing led to the delivery of the world's first production shearography NDI system in 1987 for select aircraft production programs. The introduction of the first portable shearography systems occurred in 1989 to fill a need for fast, large-area field inspection of aircraft honeycomb structures.

7.1.3 Why Use Laser Shearography Inspection.

7.1.3.1 Key benefits of Laser Shearography include:

- Non-Contact Inspection
- Non-Contaminating Inspection
- High throughput of parts being inspected
- No Consumables (Film, couplant)
- Real Time, Digitally Achievable Test Results
- Easy Interpretation of Results
- Portable for Field Use
- Single Sided Testing (Far Side defects can often be detected from the near side.)

7.1.4 Consideration for Laser Shearography Inspection.

7.1.4.1 Test Surface Condition. It is important that the test surface provide the ability to obtain reflected laser light from the test object with sufficient power and uniformity to generate a useful image. Black parts may have so little reflection; the inspection area is small or the resulting image quality is insufficient to evaluate indications. In this case, a coating such as dye penetrant developer may be used to enhance the reflectivity of the part since the most optimal condition is a light colored, matte surface.

7.1.4.2 Test Part Geometry. Highly curved parts such as a filament wound tank may have a glare area of high laser light intensity that can cause image saturation requiring high dynamic range cameras.

7.1.4.3 Test Part Motion and Stability. The camera and test part should remain mechanically stable. Motion between the camera and the object during the data collection may degrade image and data quality, or make the shearography images unusable.

7.1.4.4 Background physical noise and thermal gradients. While performing thermal stress techniques with long data acquisition periods, the changes in thermal gradients within the work environment and background physical noise can cause a de-correlation of the shearography data. It may be necessary to use fans to control air movement and reduce the effects of thermal gradients.

7.1.4.5 Sensitivity to Defects and Detection Capability. The sensitivity of shearography to defects depends on many factors including part geometry, defect area, defect type (embedded foreign material, void or delamination), material stiffness or modulus and depth below the surface. In general, as defect depth increases, the minimum detectable size also increases. The evaluation of shearography for a given application must take into consideration all factors affecting the system, defect detection throughout the full range of depth and location, as well as operator issues such as the field of view (FOV) that will affect the probability of defect detection.

7.1.4.6 Distortion and Poor Image Analysis. The shearography image consists of two offset interferograms of the test part surface, so the image of defect indications appears larger in the direction of the Shear Vector axis by an amount equal to the magnitude. The shearography image of complex shapes or at the edges of a panel can complicate image analysis.

7.1.4.7 Material Types and Condition. Shearography depends on test part deformation to reveal subsurface defects. Elastic materials such as composite laminates, sandwich panels, plywood, metal and composite materials usually have critical flaw sizes sufficiently large to be detected with shearography methods. Brittle materials and materials with very small coefficients of thermal expansion (Ct), such as glass, silicone nitrides and ceramics, usually have very small critical flaw sizes and are not candidates for shearography inspection.

7.1.5 Advantages of Laser Shearography Inspection.

- a. Shearography methods are real-time and full field inspections.
- b. Non-contact, non-contaminating, non-wetting in some of the applications depending on the method of stress used.
- c. Single side inspection capable.
- d. Can be applied during the manufacturing process to detect defects at the earliest stage possible.
- e. Once qualified, shearography methods can be highly cost effective and achieve production throughputs ranging from 25 to 1200 sq. ft./hr, depending on the technique and the application.
- f. Dual channel systems can operate with a very high throughput of 800 sq. ft./hr. It can be used on helicopter blades, honeycomb or foam core structures and laminate panels.
- g. Hand held portable vacuum shearography instruments for on-aircraft honeycomb applications can inspect up to 150 sq. ft./hr.

- h. Inspects structures with a wide range of materials and geometries that pose challenges to more conventional NDI techniques.
- i. Shearography techniques do not require exact part contour following. Test parts surfaces can be inspected even at angles of 45 degrees or more allowing inspections into otherwise tight inaccessible areas.

7.1.6 Disadvantages of Laser Shearography Inspection.

NOTE

Although advantages and disadvantages may appear to be straightforward, the decision to select the Laser Shearography method or any other NDI method is often not obvious and depends upon a large number of factors. A thorough knowledge of the capabilities and limitations of all NDI Methods is required. Whenever possible, the decision on which method to use should be referred to the responsible NDI engineering activity.

- a. Relative motion between part under inspection and Shearography Camera must remain stable.
- b. Shearography inspection utilizes laser light so safety of all personnel must be considered. Awareness of work area behind the part under inspection must be monitored so personnel are not exposed to the laser hazard unintentionally. In some cases, laser eye protection (i.e. laser safety goggles, barricades) may be required.
- c. Thin components or parts may deform under stress resulting in De-correlation on image.
- d. Stressing the part with high intensity acoustic vibration exceeds the allowable limits for exposure to noise. A noise level exposure analysis must be conducted before using this stressing method to determine the appropriate personnel protective equipment.

SECTION II PRINCIPLES AND THEORY OF LASER SHEAROGRAPHY INSPECTION

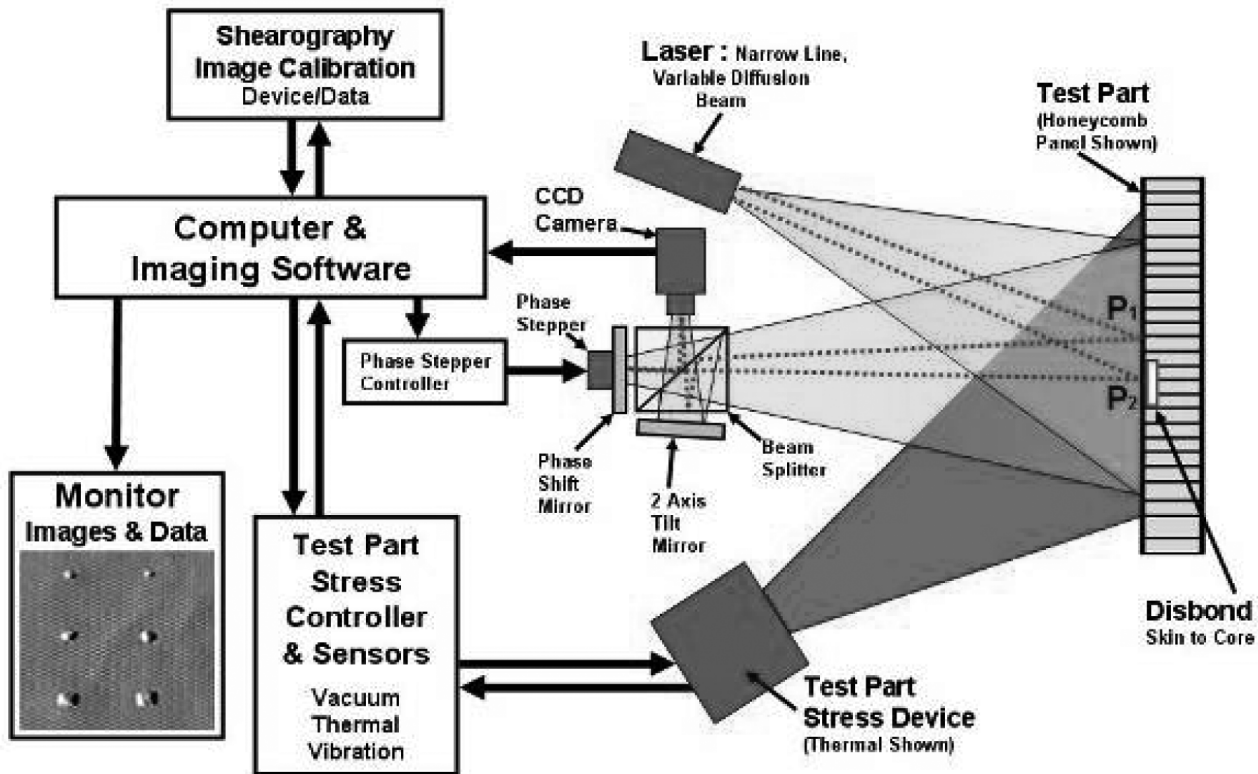
7.2 PRINCIPLES AND THEORY OF LASER SHEAROGRAPHY INSPECTION.

7.2.1 Principles of Shearography.

7.2.1.1 A shearography NDI system consists of a laser light source, a shearing image interferometer, an image processing computer, display monitor and a means to provide a controlled and repeatable stress to the test object. The shearography optical system is what is referred to as a common path imaging interferometer. Shearography cameras create images showing the first derivative of the out-of-plane deformation of the test part surface in response to a change in load. Shearography is relatively insensitive to test object bending or deformation due to the applied stress, but is still highly sensitive to local deformation caused by a defect.

7.2.1.2 Shearography cameras are sensitive to changes in the distance from the object surface to the camera. In practice, z-axis surface deformations may be as small as 2-20 nanometers depending on the environmental noise. Large test parts can be inspected with a small number of images using a large field of view (FOV) or a large number of images with a smaller FOV that may be automatically stitched together. The FOV for a shearography camera depends on the maximum allowable defect size, camera resolution, laser illumination power, the ability to uniformly apply a stress change and the amount of background noise.

7.2.1.3 A shearography schematic diagram is shown in [Figure 7-1](#) that includes the laser and optical elements for test part illumination and imaging shearing optical system consisting of a beam splitter with a 2 axis tilting mirror, a second mirror with a Piezo-Electric Transducer (PZT) Phase stepper and the Charge-coupled Device (CCD) camera. The laser light is expanded through lenses to illuminate the test area on the panel. Light from point P1 is reflected from the panel surface where it is well bonded to the core. Light from point P2 is reflected from the surface above a skin-to-core disbond. If the panel is stressed with a small temperature change or a partial vacuum, the panel face sheet above the disbond will deform out-of-plane towards the shearography camera. This shorter distance traveled by light from point P2 causes a phase shift with respect to light from point P1. Light from both P1 and P2 are combined by the shearing interferometer at a single pixel in the CCD array.

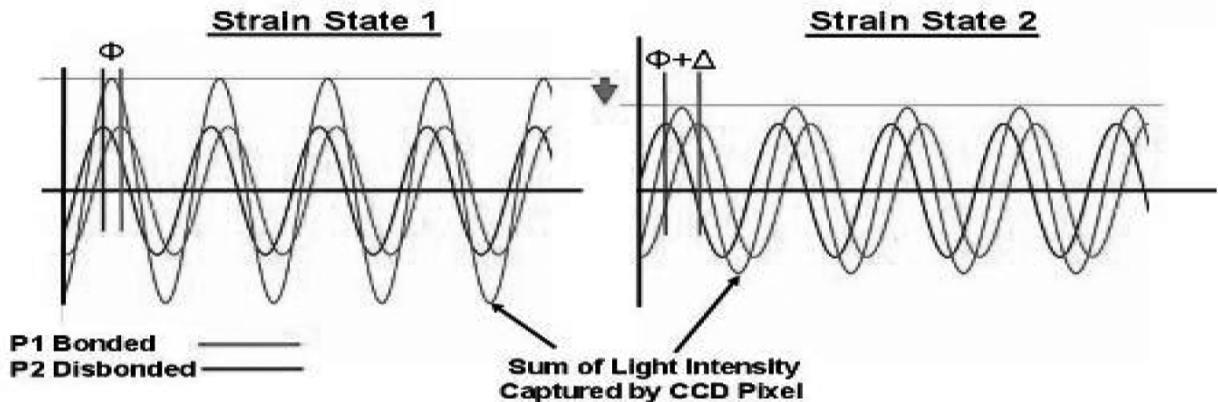


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Figure 7-1. Schematic Diagram of Shearography Camera and Thermal Stress System

7.2.1.4 The separation distance and direction, or shear vector, between the paired points P1 and P2 on the test part surface, determines the camera sensitivity to surface deformation. The light intensity detected by each pixel in the CCD camera is determined by the complex addition of the light from these two points on the target.

7.2.1.5 The illustrations in [Figure 7-2](#) shows how the coherent, single frequency light (i.e. laser light), from adjacent points on the part, are combined in each pixel in the shearography camera. The random phase difference Φ results from the random surface roughness on a diffusely reflecting test part surface. Stressing the part causes a relative phase shift Δ (delta) between light from well bonded homogeneous material and light from the surface above defective or non-homogeneous material. In two dimensions, this is expressed as $\Delta(x, y)$.



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Figure 7-2. Coherent Single Frequency Light

7.2.1.6 The phase stepper in the optical system applies a $\pi/2$ phase step at video frame rates (typically 30 frames/second) to one leg of the shearing interferometer to allow the calculation of the phase map and subsequent quantitative determination of the deformation derivatives between two strain states. As the applied load on the test object is changed, two sets of phase stepped images are captured and the phase calculation is performed for each pixel over the image.

7.2.2 Basic Terminology. The following terms and definitions are basic to an understanding of the Laser Shearography Method.

7.2.2.1 Acoustic Stress (Acoustic Excitation). Method used with shearography or holography cameras to image anomalies in a material using air coupled vibration typically in the range between 500 Hz and 20 kHz. This NDI method is completely non-contact and remote. High sound levels above 85 dB require safety precautions. (see [Paragraph 7.7.4](#), Acoustic Stress Hazards)

7.2.2.2 Beam Ratio. The ratio of the intensity of the reference beam and the object beam measured at the plane of the CCD sensor in a camera. The beam ratio is typically set between 4:1 and 2:1 depending on camera design.

7.2.2.3 Beam splitter. An optical element capable of splitting a single beam of coherent laser light into two beams. Beam splitters are key elements in Michelson Type Image Shearing Interferometers.

7.2.2.4 Coherent light source. A light source that converts electrical energy to a monochromatic beam of light having uniform phase over a minimum specified length known as the coherent length.

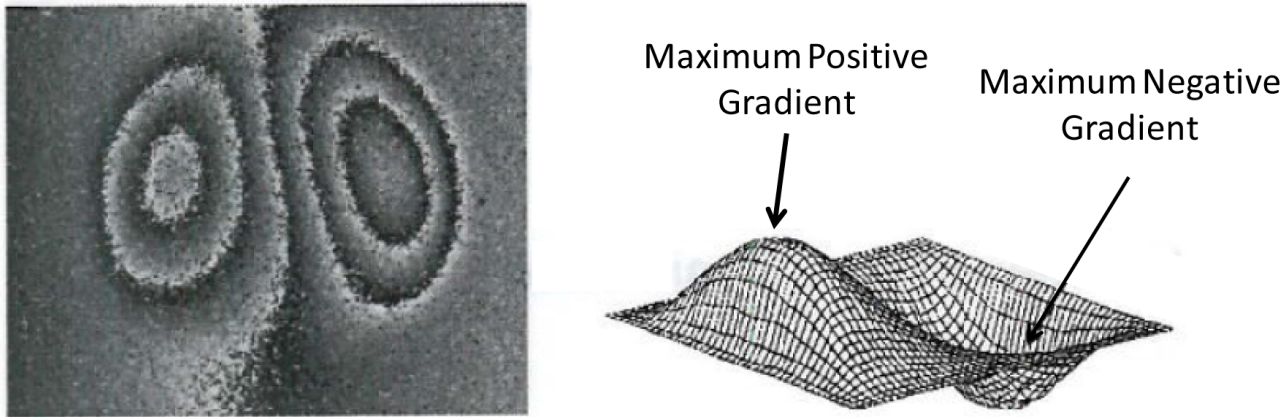
7.2.2.5 De-correlation. A loss of shearographic phase data caused by test part deformation exceeding the resolution of the imaging interferometer sensor or motion occurs between the test object and shearing interferometer during data acquisition.

7.2.2.6 Displacement derivatives. The rate of spatial displacement change, $(\partial w/\partial x, \partial w/\partial y)$, where w is the surface displacement and x is the surface coordinate.

7.2.2.7 Emissivity. A property of a material that describes its ability to radiate energy by comparing it to a blackbody (a perfect radiator) at the same temperature.

7.2.2.8 Field of View (FOV). The horizontal and vertical distances an image covers on a test part measure in inches (mm.) in the plane of the test part. Where F^x and F^y are the field of view in the x and y directions $F^x = P^x/I^s$ and $F^y = P^y/I^s$, where P^x , P^y is the camera CCD pixel count in the x and y directions and I^s is the Image Scale in pixels/inch measured in the plane of the test object.

7.2.2.9 **Fringe pattern.** A set of lines in a subtraction or wrapped phase interferogram, that in a shearogram represents the locus of points with equal out-of-plane deformation derivatives (change in slope) or for a hologram the locus of points with equal out-of-plane deformation, translation and rotation (Figure 7-3).



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Figure 7-3. Fringe Pattern

7.2.2.10 **Image Calibration.** Image calibration allows accurate measurement of features, separation distances and indications in shearographic and holographic images. Shearography image calibration consists of two components: the image scale in pixels per inch (mm) at the plane of the part surface and the shear vector.

7.2.2.11 **Image File.** Shearographic and holographic images and calibration data are saved in file formats that preserve the image phase data and image calibration data fields, such as .pmf or .psf. Image formats without embedded calibration data include .jpeg, .tif.

7.2.2.12 **Image Scale (Is).** A measurement of the image resolution for an interferometric image of a test part measured in pixels/inch (mm) in the plane of the test part surface. Assuming the camera CCD has square pixels, the $I_s = \text{pixels/in (mm)}$.

7.2.2.13 **Indication.** The observation or evidence of a condition resulting from the shearographic examination that requires interpretation to determine its significance, characterized by dimensions, area, signal to noise ratio or other quantitative measurement.

7.2.2.14 **Interference.** A phenomenon resulting from the complex addition of waves. Two similar waves meeting "peak to peak" will tend to amplify each other, while these same two waves meeting "peak to trough" will tend to cancel each other out.

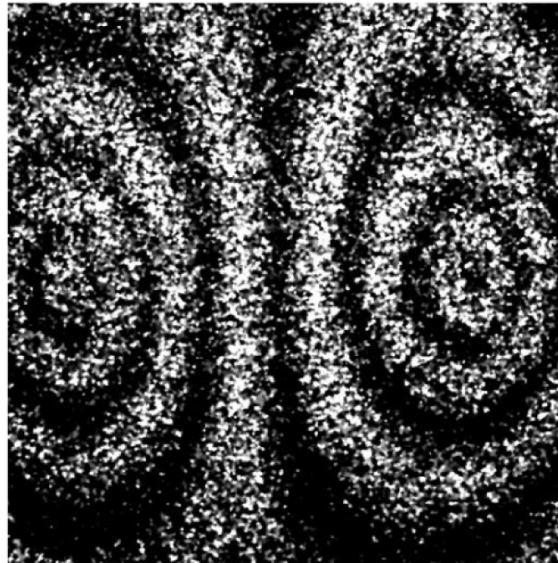
7.2.2.15 **Interferometry.** The use of optical interference for the purpose of making measurements or observing changes.

7.2.2.16 **Interferometers.** Device designed for creating interference between waves for the purpose of measurement.

7.2.2.17 **Out-of-plane displacement.** The local deformation of a test part, normal to the surface, ($\partial w/\partial yz$) where w is the surface displacement, caused by the application of an engineered force acting on a non-homogeneity or defect in a composite material.

7.2.2.18 **Phase Map.** An image of a test object surface contour changes over time calculated from multiple phase stepped interferograms. The phase map consists of grey levels varying from black to white with each grey level corresponding to an equal change in surface contour or first derivative of the change in surface contour due to a change in an applied stress.

When deformation of a test panel exceeds $\lambda/2$, the grey level jumps from black to white and repeats every multiple of $\lambda/2$ (Refer to [Figure 7-4](#)).



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Figure 7-4. Phase Map

7.2.2.19 Phase Reversal. An interferometric image of a panel in continuous vibration made with multiple negative phase shifts resulting images of vibration modes and structural anomalies.

7.2.2.20 Phase Stepping, Phase Shifting. A spatial shift of one optical beam path in an imaging interferometer during data acquisition allowing the calculation of the test panel deformation derivative phase map.

7.2.2.21 Scan Plan. A designed sequence of steps for positioning and adjusting a shearography camera to accomplish a desired inspection. Scan plans shall include camera field of view, percentage of image overlap, position sequences for each area to be tested, test number and location in a coordinate system appropriate for test object geometry and access.

7.2.2.22 Signal to Noise Ratio (S/N). The ratio of the shearography defect signal strength divided by the signal strength from well bonded material adjacent to the defect.

7.2.2.23 Shearogram. The output image of an image shearing interferometer showing the deformation derivative for the surface of a test object subject to a change in an applied load. The shearogram may reveal subsurface anomalies such as disbonds, voids, delaminations as well as surface damage. The shearogram contains embedded calibration data for image scale in pixels/inch (mm) and the shear vector to allow precision measurement of size, area and location of features or anomalies. The shearogram may be processed with various image processing algorithms and may be displayed as real-time or static wrapped or unwrapped phase maps or may be integrated to show quantitatively the test object deformation.

7.2.2.24 Shearography camera (shear camera). An image shearing interferometer used for shearography nondestructive testing, usually including features for adjustment of focus, iris, zoom, shear vector and projection and adjustment of coherent light onto the test object area to be inspected.

7.2.2.25 Shear Vector. The separation vector between two identical images of the target in the output of an image shearing interferometer. The shear vector is expressed in degrees of angle from the X axis, with a maximum of 90° , with + being in the positive Y direction and - in the negative Y direction. The shear distance between identical points in the two sheared images expressed in inches or mm.

7.2.2.26 Stressing Device. The means to apply a measurable and repeatable engineered stress change to the test object during Shearography Inspection. The applied stress may be in the form of a partial vacuum, pressure, heat, vibration, magnetic field, electric field, microwave, or mechanical load. Also referred to as excitation or excitation method.

7.2.2.27 Thermal Stress, Excitation. Method used with shearography cameras to image local changes in material coefficient of thermal expansion caused by the presence of anomalies including disbonds, impact damage, FOD or structural elements. Thermal stress uses heating for material with a positive Ct, such as aluminum or carbon fiber laminate, and cold air for materials with a negative Ct, such as Kevlar.

7.2.2.28 Unwrapped Phase Map. The summation of all phase measurements for each point in the camera field of view. Unwrapped phase maps eliminate fringe interpretation and yield an image of the local deformation of a test part caused by the presence of an anomaly within the range of detection.

7.2.2.29 Vacuum Stress, Excitation. Method used with shearography cameras to image local changes in material stiffness due to the presence of air containing voids, disbonds or delamination.

7.2.2.30 Vibration Stress, Excitation. Method used with shearography cameras to image local changes in material compliance. Vibration stress shearography uses either vibration source in physical contact with the part or coupled through air.

7.2.2.31 Wavelength. The wavelength of laser light output, λ , usually expressed in nanometers (nm.). Common wavelengths for frequency doubled YAG lasers used in shearography range from 532 nm to 660 nm.

7.2.3 Stressing Methods. Shearography detects sub-surface defects and anomalies by observing changes in the surface of the test article resulting from an applied stress. Therefore, the selection of an appropriate stressing (excitation) method is the key to successful shearographic inspection. The following is a listing of potential methods of stressing the part under inspection.

7.2.3.1 Pressurization. Increase or decrease the pressure within the test article and observe the effects on the surface. Normally, used to inspect pressure vessels, rocket motors, storage tanks, pipes, boiler tubes, and compartmentalized metallic and composite structures.

7.2.3.2 Vacuum Stressing. Decrease the pressure surrounding the test article thus effectively creating a pressure difference between the internal pressure within the test article and the surrounding area. For this method to be successful the test article must have some "air" content and be capable of maintaining the pressure differential. Two methods of vacuum stressing are available for use.

- a. Whole Body Vacuum Stressing. The test article is placed within a Vacuum Chamber when this method is used. One limiting factor is the part must fit within the Chamber.
- b. Single Sided Vacuum Stressing. This is used by portable systems and the pressure reduction is on one side only. It utilizes both the expansion of air with the test article and a mechanical "pulling" on the outer surface of the test article. Commonly used on test structures that are too large or impractical to fit into a vacuum chamber.

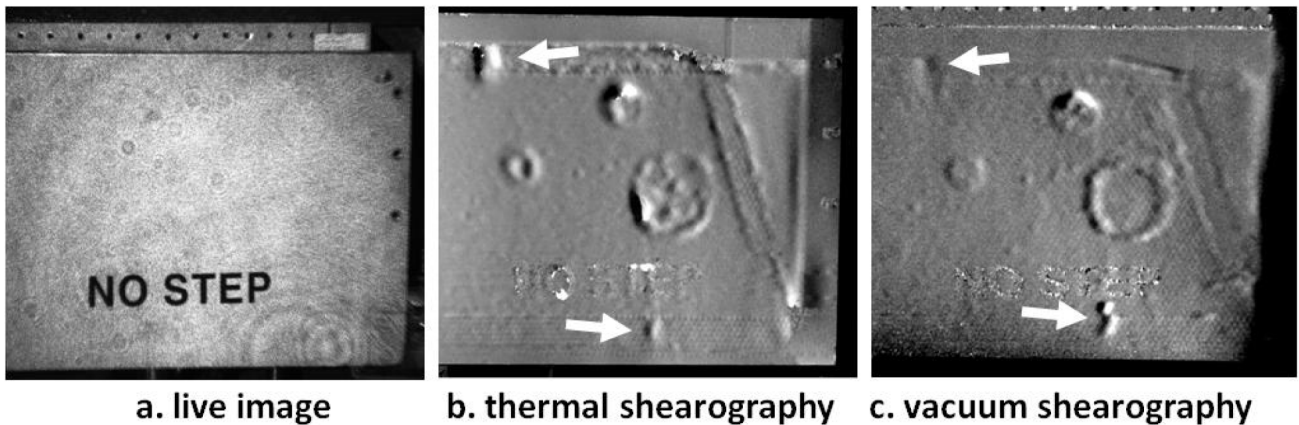
7.2.3.3 Thermal Excitation. Thermal Stressing takes into account that different materials expand and contract at different rates when heated based on that material's "coefficient of thermal expansion". This method requires only a temperature change be applied to the test article between the reference and final images. Meaning that thermal stressing applies equally well to both heating and cooling. The temperature change required for shearography of most composite structures is typically a few degrees Fahrenheit. It is dependent on the material under inspection.

7.2.3.4 Vibration Stressing. Two methods of vibration stressing are available; Acoustic Stressing and Mechanically Coupled Vibration.

7.2.3.4.1 Acoustic Excitation. Air Coupled Acoustic Vibration (ACAD) uses high intensity acoustic vibration to stress the test article. The types of excitation used include fixed frequency, variable frequency, or white noise. Under this method of stressing, areas of disbond or anomalous structure will resonate at different frequencies than uniform structure. When using this method, no contact is made with the test article.

7.2.3.4.2 Mechanically Coupled Vibration (MECAD). During MECAD Stressing, the test article is stressed using vibration excitation with a mechanical coupled transducer. This transducer is clamped, vacuum attached, or otherwise physically attached to the test article or to a fixture holding the test articles. Areas of disbond or anomalous structure will resonate at different frequencies than uniform structure. Common applications when inspecting rigid metallic honeycomb structures, rigid bonded metallic structures, and engine fan cases.

7.2.3.5 Mechanical Loading. Mechanical stressing is when the test article is physically stressed (e.g. compression, bending, twisting...). A uniform response is expected from a uniformly bonded structure. An example of a part inspected with thermal excitation and vacuum stressing methods are show in [Figure 7-5](#).



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Figure 7-5. Shearography Results of an Aircraft Slat

SECTION III LASER SHEAROGRAPHY EQUIPMENT

7.3 LASER SHEAROGRAPHY INSPECTION EQUIPMENT AND MATERIALS.

7.3.1 Selection of Laser Shearography Inspection Equipment. When selecting Laser Shearography equipment, the inspector must consider location of part under inspection and the optimum stressing method to reveal any flaws. A variety of equipment is available which can be used for systems that attach to or stand independent to the part under inspection.

7.3.2 Components of the Laser Shearography Systems. In the simplest form, a shearography system consists of the following components:

- a. Stress Mechanism
- b. Laser
- c. Shear Camera
- d. Processing System

7.3.2.1 Stress Mechanism. Some method of stressing is necessary to cause the necessary displacement of the test articles surface.

7.3.2.1.1 Thermal Stressing Equipment. Thermal stressing equipment must be capable of making the necessary temperature changes in the article being tested. High intensity lamps or heat guns are examples of equipment commonly used to thermally stress a test article.

7.3.2.1.2 Vacuum Stressing Equipment. Vacuum stressing equipment must be capable of decreasing the pressure surrounding the test article. This could be either the whole body or single side of the article. Vacuum chambers are used for whole body vacuum stressing while vacuum heads attached to test article are used for the single side vacuum stressing.

7.3.2.1.3 Vibration Stressing Equipment. ACAD utilizes in the Acoustic Range of 1 to 20 kHz generating sound pressures in the 80 - 135 dB range. MECAD utilizes a higher frequency range of 5 kHz to 200 kHz.

7.3.2.1.4 Pressure Stressing Equipment. Pressure stressing equipment must be capable of decreasing or increasing the internal pressure of the test article. Hand pumps or vacuum pumps are examples of equipment commonly used to pressure stress a test article.

7.3.2.2 Laser. Some manufactures have the lasers enclosed within the same housing as the camera, while others have the lasers attached around the camera. Regardless to the physical location of the laser, ensure the safety requirements in [Paragraph 7.7](#) for laser safety are followed to protect all maintainers.

7.3.2.3 Shear Camera. The Shear Camera is an image shearing interferometer, usually including features for adjustment of focus, iris, zoom, shear vector and projection and adjustment of coherent light onto the test object area to be inspected.

7.3.2.4 Processing System. A computer interface used to operate the shear camera, process the image acquired from the shear camera, operate the shear camera, and allow for evaluation of the image.

SECTION IV APPLICATION OF LASER SHEAROGRAPHY INSPECTION

7.4 APPLICATION OF LASER SHEAROGRAPHY INSPECTION.

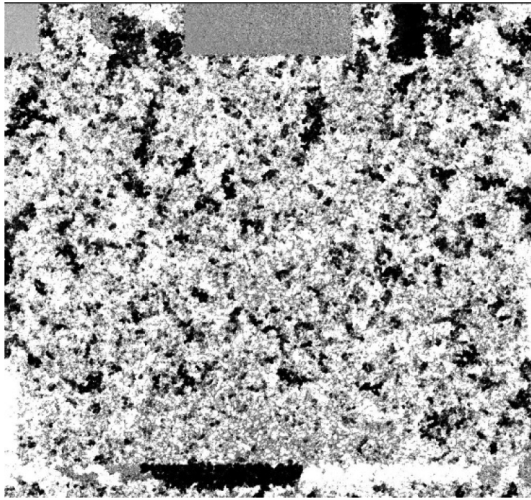
7.4.1 General. This section provides basic, intermediate and detailed information on the specific processes relative to the performance of Laser Shearography Inspection. Function not specifically performed by NDI personnel, such as part disassembly, are not covered under this section.

7.4.2 Basic Inspection Process. The operation of a shearography NDI system involves a series of important system setup steps, listed in [Table 7-1](#), to be performed in order to achieve acceptable test results. Detailed descriptions of each step are contained in later sections.

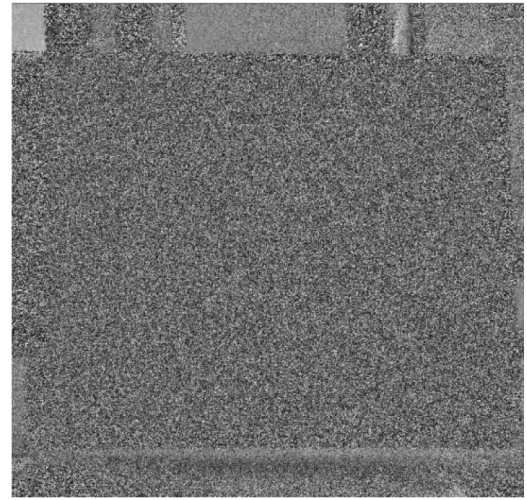
Table 7-1. Shearography NDI Set Up and Process Steps

1	Fixture the test object
2	Determination of the Field of View (FOV)
3	Development of a test scan plan
4	Focusing the camera
5	Optimizing of the shearography camera settings
6	Selection of an appropriate stress test method

7.4.2.1 Fixture the Test Part. Test part mechanical stability is important during shearography NDI. A part that moves during stressing or data acquisition may cause the image to de-correlate requiring re-test. Parts should be securely positioned against a mechanically stable backstop or support fixture. Any debris should be removed from the surface of the fixture. Thin or light weight test parts may vibrate due to vacuum chamber noise or ambient machinery in the area of the test. Shims, clamps, tape, or foam pads may be used to secure the part and dampen vibration. A secured part will appear black when the reference images are captured. Care must be taken to place honeycomb parts on the outer skin and not rest on the honeycomb material. During partial vacuum stress the honeycomb may expand and cause the part to become mechanically unstable resulting in de- correlation of the shearography image ([Figure 7-6](#)).



De-Correlation Unwrapped Phase Map



De-Correlation Wrapped Phase Map

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Figure 7-6. De-Correlation Unwrapped and Wrapped

7.4.2.1.1 During testing in a vacuum chamber, the test part must never come in contact with any part of the chamber walls or frames. Even small movements of several hundredths of an inch can degrade image quality. Vacuum loads on chamber walls can reach many tons, for even a modest sized chamber and the steel frames and panels deform significantly. Test parts that touch these components will move and de-correlate the shearography image.

7.4.2.1.2 When testing on aircraft or large parts unable to fit into a vacuum chamber, it may be necessary to have a camera attached to the component to prevent de-correlation during the inspection process. Some portable systems use vacuum feet to attach to the part to ensure stability.

7.4.2.2 Field of View (FOV)

7.4.2.2.1 Shearography NDI applied to aircraft and spacecraft structures can use a FOV varying from 4 x 4 inches to more than 36 x 36 inches, but the sensitivity to defects will change considerably as the FOV is increased. The technician should use the zoom control to adjust the FOV per the specific inspection procedures. In order to obtain the maximum throughput for in-process shearography inspection the maximum FOV is desired. Key factors affecting the FOV for a shearography camera are camera pixel count in the x and the y direction, the maximum allowable defect size for a specific structure and application, defect indication definition (area), and image noise.

7.4.2.2.2 The maximum FOV for a shearography camera is determined by the following variables:

- a. Shear camera CCD pixels in horizontal and vertical axis, P_x and P_y , in pixels
- b. Dimensions, X and Y, of the largest allowable defect, D_x and D_y , in dimensional units
- c. Minimum pixel count required to define a defect indication, I_x and I_y in pixels
- d. Optical resolution of the shearography system
- e. Environmental factors affecting the defect indication signal to noise (S/N) ratio

7.4.2.2.2.1 The maximum allowable defect size, (D_x , D_y) is determined through engineering fracture mechanics techniques, stress analysis of the structure or historical failure analysis data. Typical maximum allowable defect sizes used in NDI

specifications generally include an additional safety factor. The quantity and proximity of defects that are larger than the maximum allowable defect size must be recorded for analysis and disposition. To maximize inspection throughput, the maximum FOV must be determined that will allow the operator to detect the indications equal to or larger than the specified maximum allowable defect.

7.4.2.3 Developing a Scan Plan. Test targets larger than a single FOV image require multiple images to cover the surface to be inspected. Multiple images must have overlap to ensure that no region is missed. Typically a 10% overlap in both directions is recommended. Manual handheld shearography systems can use a visual marking method as guidance for camera placement on large panels. It may be necessary to grid out the scan plan to verify the coverage. Large gantry systems usually have a graphical interface to allow rapid scan programming on large parts.

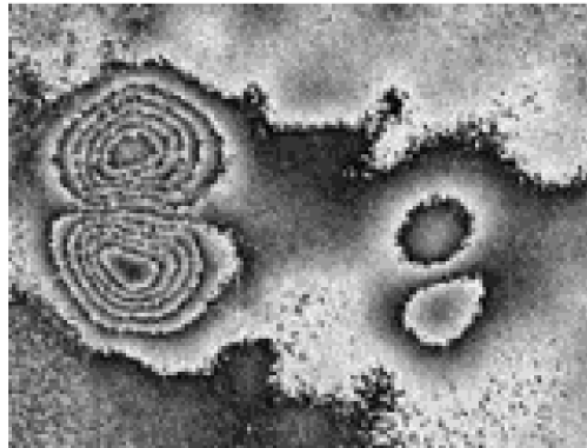
7.4.2.4 Focusing the Camera. It is necessary for the camera to be in focus to allow for the best result from the inspection process. In order to obtain the sharpest focus from the shearography camera, it is critical to focus with the camera set to its minimum practical depth of field. This is obtained by opening the iris of the camera lens until the "live" image of the test article is as bright as possible while still being able to resolve some surface details (required for focusing). Adjust the focus control of the camera to achieve the sharpest image of the selected surface details or use a "focusing target" attached to the surface of the test article.

7.4.2.5 Optimizing of the Shearography Camera Settings. In order to provide the best images on screen it is necessary to optimize the Iris, Shear Vector, and complete the calibration of the video caliper.

7.4.2.5.1 Iris. The optimal camera iris setting will allow the maximum amount of light into the shearography camera while maintaining good imaging of the test article itself. It is recommended that the iris be open until areas of the test article is seen to be saturated (turns pure white with no detail). Reduce the iris until a uniform laser speckle can be seen across the intended inspection area. Try and reduce areas of saturation without sacrificing overall image quality. If glare or brightly painted surfaces cause small areas of saturation and the image quality cannot be maintained when collecting the image, it may be necessary to perform a second test in these areas from a slightly different angle.

7.4.2.5.2 Shear Vector.

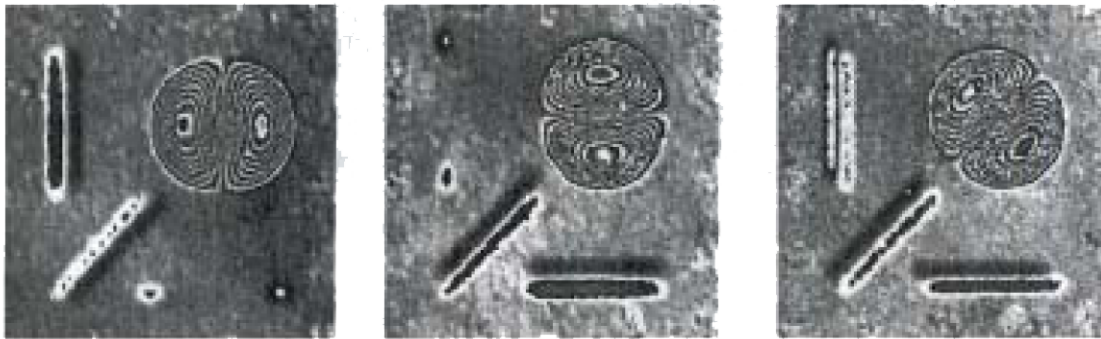
7.4.2.5.2.1 Shearography indications generally possess a "double lobed" shape and the orientation of the shape provides information as to the shear axis of the shearography camera (Refer to [Figure 7-7](#)).



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Figure 7-7. Shear Axis

7.4.2.5.2.2 The shear axis is defined by the separation of the "sheared" image of the test article as seen through the camera. The direction of the shear defines the direction of maximum sensitivity for the test results.



Horizontal Shearing
 Vertical defect visible but
 only end points of horizontal
 indication visible.

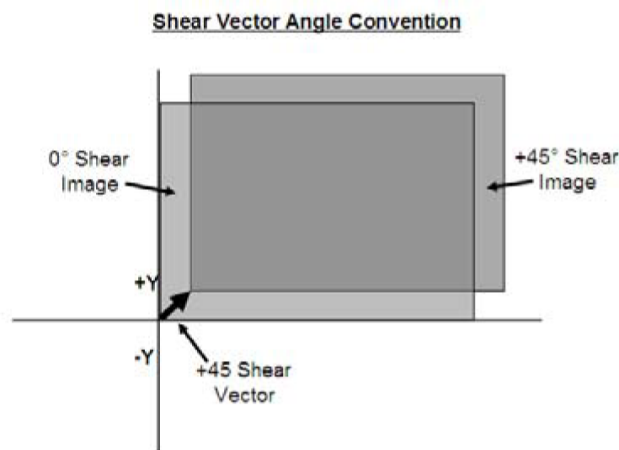
Vertical Shearing
 Horizontal defect visible but
 only end points of vertical
 indication visible.

Shearing at 45 degrees
 Both horizontal and vertical
 indications visible.

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Figure 7-8. Horizontal Shearing, Vertical Shearing, and Shearing at 45 Degrees

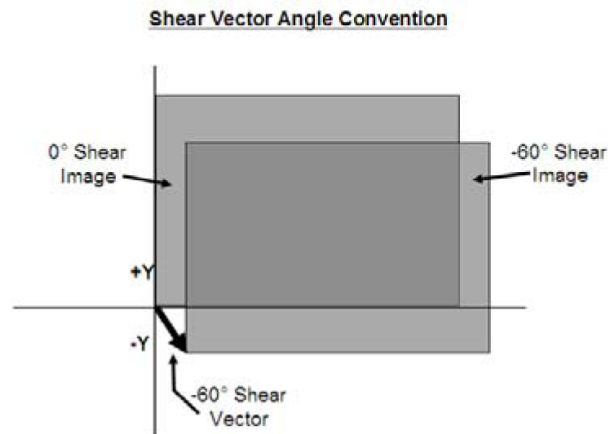
7.4.2.5.2.3 Setting the magnitude (shear distance) will ensure the sensitivity of the inspections. The shear vector in a shearography test procedure is expressed as the amount of image separation and the angle, using the shear angle convention shown in the [Figure 7-8](#). The shear vector is written for example as $S_v = 0.25$ inches @ $+45^\circ$. Starting with the shear camera adjusted for a 0° shear condition, the sheared image is moved to the right (+X) or up/down, never adjusted in the direction of -X. For a $+45^\circ$ shear vector, the image is moved in the +X and +Y direction ([Figure 7-9](#)).



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Figure 7-9. 45 Degree Shear Vector

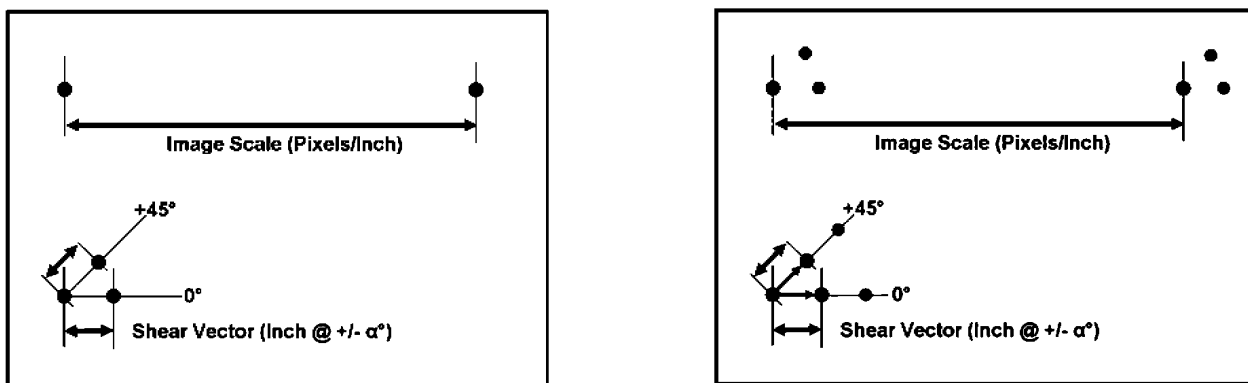
7.4.2.5.2.4 For 60° Shear Vector ([Figure 7-10](#)), the image is adjusted in the +X and -Y directions. The convention allows determination of deformation in the z-axis direction from the unwrapped phase map. In addition, adherence to this convention allows the operator to use the phase of an indication to distinguish between a repair and damage to a structure.



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Figure 7-10. Negative 60 Degree Shear Vector

7.4.2.5.2.5 Manual calibration of a shearography test set up is accomplished before the start of any testing, by placing a shear vector calibration card on the test part surface with the shearography camera displaying the live image, [Figure 7-11](#), item a, shows a shear vector calibration card with two sets of marks or dots with known separation so that all are visible at the desired image magnification. The two dots more widely separated are used for the image scale while the two dots closer together, and possibly at an angle are used to set the shear vector. The shear vector selected is based on test objects for the material, thicknesses and part geometry. The image scale dots should be at least two inches apart. With the calibration card in place, the shear vector is adjusted so the left shear vector dot is placed on top of the right shear vector dot. The operator will then see three shear vector dots on the screen. The image scale is set into the shearography image processor using the system software shear camera calibration tool to measure the distance between the image scale dots. With the shear vector applied, four paired image scale dots will be seen on the monitor as shown in [Figure 7-11](#), item b. The image scale is determined by measuring the distance between the left or right sets of dots. The shear vector is set by adjusting the shear camera tilt mirror to move the left dot in the moving sheared image onto the right dot in the stationary image. Once the shear vector is set, three dots will be seen, the center dot consisting two dots overlaying each other.



a. calibration card

b. aligned image through shear camera

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Figure 7-11. Shear Vector Calibration Card (Left)/Image Scale Dots (Right)

7.4.2.5.2.6 Shearography cameras must be recalibrated each time the Shear Vector or the image magnification is changed unless the camera is fitted with encoders and software allowing an automatic reset of the Shear Vector to a correct value for a test. Shearography cameras are also available with automatic image calibration using projected light patterns, with known dimensions, onto the plane of the test part. The system software then measures and sets the operator selected image scale and the Shear Vector.

NOTE

If using a "fixed shear angle" shearography camera, the orientation of the shear angle can often be adjusted by rotating the shearography camera. The magnitude of the shear could also be adjusted by changing the part to camera distance.

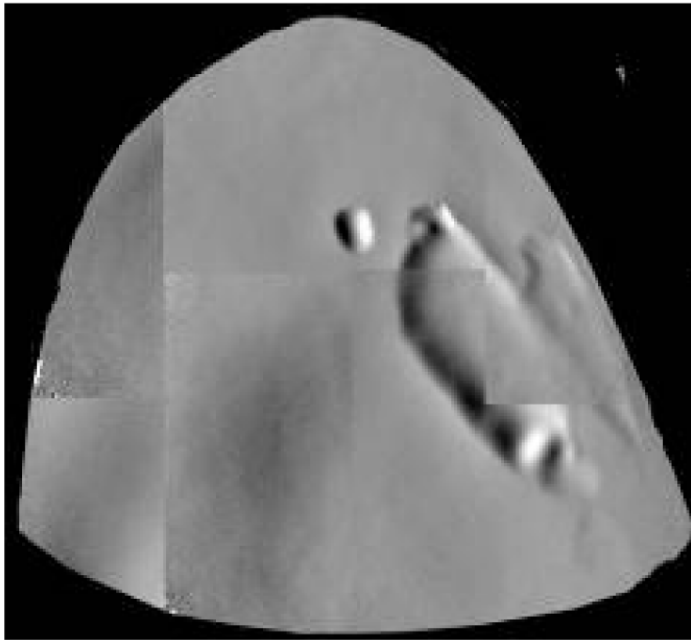
7.4.2.5.3 Video Caliper Calibration. Some shearography systems have a built in video caliper that allows shearography indications to be accurately measured during a production inspection. The video caliper calibration is accurate only for 1 image magnification and shear vector setting. Changing the part to camera distance, the camera zoom, or the shear vector will result in the video caliper having to be re-calibrated. Perform the calibration after the shearography camera zoom, focus and iris are set; select the live video display on the image processor. Place a test target with a known size on the part to be inspected.

7.4.2.6 Selection of an Appropriate Stress Test Method. The selection of the shearography stress method for a particular structure is highly dependent of the defect type, geometry of the structure and material properties. One stress method may reveal anomalies where another method will not reveal the anomalies in the test article. [Table 7-2](#) lists stress methods of thermal, partial vacuum, pressure and vibration, and their potential areas of application.

7.4.2.6.1 Thermal Shearography

7.4.2.6.1.1 Thermal shearography can be applied successfully to a wide range of structures and material types including solid laminates, metal or composite sandwich panels (limited to near side inspections only), COPV and even be used for crack detection in metal and ceramics. Unlike thermography, which images surface temperature changes (or derivatives) over time, thermal shearography uses a temperature change to reveal local changes in the coefficient of thermal expansion, C_t , due to the presence of an anomaly. Thermal shearography is not affected by the test part emissivity and is equally able to inspect bare aluminum or painted surfaces without any preparation except to remove any grease or dew. For materials with a positive C_t , which includes most materials such as carbon laminate, aluminum, steel and fiberglass the test part surface is heated. For materials with a negative C_t , such as Kevlar, the component part must be tested by cooling the surface. When using a thermal stress method care must be taken to not thermally saturate the part under inspection. Allow adequate time for the component to cool/warm before inspecting the same or adjacent area.

7.4.2.6.1.2 Thermal stress is typically accomplished using radiant light with a high IR component but can be accomplished using a heat gun as long as the heat is applied uniformly. An example of test results from part inspected using thermal stressing is in [Figure 7-12](#).



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Figure 7-12. Thermal Shearogram for a Section of a Large Aircraft Radome Showing Eight Sequential Tests from a Fixed Position

Table 7-2. Stress Methods and Applications

Method	Units	Range	Applications
Thermal	Degrees Temperature Change	1 to 30°F	Laminate Panels Impact Damage, Delamination, Wrinkled Fibers, Porosity, Inclusions, Embedded Foreign Material, Repairs Sandwich Panel-Honeycomb, Foam Cores Impact Damage, Skin-to-Core Disbond, Damaged Core, Foam-Foam Disbonds, Metal Core-Skin disbonds, Repairs, Kissing Disbonds, Skin Delamination, Water Resin Transfer Molded Composites Resin Lean Areas, Porosity, Damage Engine Stators, Vanes, Composite Fan Blades Erosion Strip Bond, Voids, Resin Lean Areas, Damage, Foreign Objects Steel, Aluminum, Ceramics, Composites Surface breaking or near surface breaking cracks COPV with metal liners Disbonds at the liner/composite bond, Fiber Bridging
Partial Vacuum	PSI, KG/CM ² Pressure	-0.02 to -7.0 PSID	Elastomers Coatings, Rubber and Plastic Voids, Disbonds, Tires, Solid Rocket Motor Liners, Rubber to Substrate Bond, Cork to Substrate Bond, Cork impact damage

Table 7-2. Stress Methods and Applications - Continued

Method	Units	Range	Applications
Pressure	Reduction	0.01 to 5,000+ PSID	Sandwich Panels-Honeycomb Foam Cores Impact Damage, Voids, Disbonds, Radomes, Aircraft Control Surfaces, Flaps, Air Brakes, Helicopter Blades, Turbine Engine Ducts, Laminated Wood Structures, Thin skinned metallic sandwich structures COPV COPV Fiber Bridging, Liner Disbonds COPV & Composite Rocket Motors Impact Damage, Composite Cracks, Broken Fibers, Fiber Bridging, Porosity Pressure Vessels & Heat Transfer Structures Metal Pressure Tanks, Liquid Propellant Rocket Engine Exit Cones, Thrust Ramps, Piping, Space Vented Core Honeycomb
	PSI, KG/CM ² Pressure Change		
Vibration	Air Coupled 0.5 to 25kHz	90 to 125dB	Foam Rocket Thermal Protection Systems Damage, Disbonds, Delamination, Cracks Light Weight Honeycomb Spacecraft Solar Panels, Solar Cell Bond Metal Honeycomb Metal Honeycomb Turbine Engine Fan Cases, Fan Blade Erosion Strip bond, Metal to Metal Bonded Panels and Honeycomb Metal Brazed Bonded & Plasma Sprayed Engine Compressor Seals Disbonds
	Mechanically Coupled 4.0 to 250kHz		

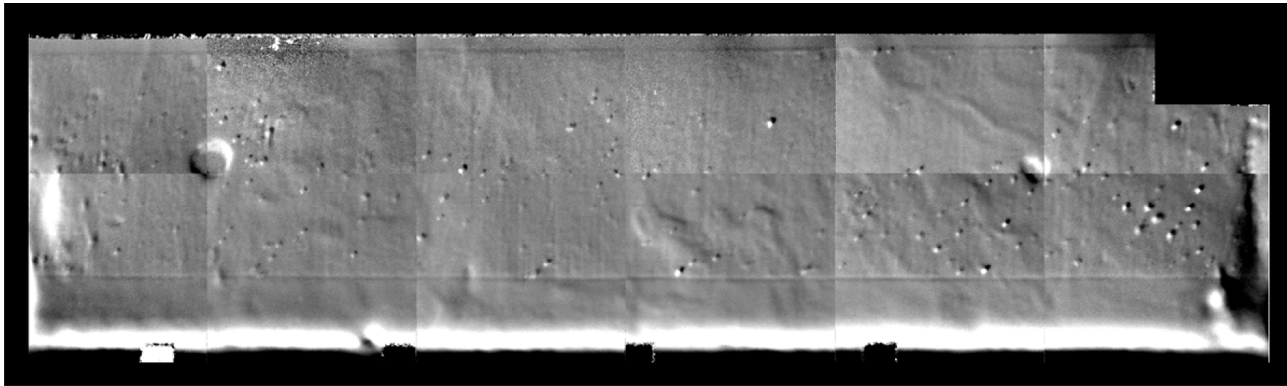
7.4.2.6.2 Partial Vacuum Shearography

7.4.2.6.2.1 Partial vacuum shearography requires the use of a test chamber capable of reducing the inside air pressure. For portable testing a vacuum window may be used consisting of a Lexan plate with edge seals and a variable, controllable vacuum blower. Often a small shear camera is built into a portable inspection head. Partial vacuum stressing reduces the outside ambient air pressure on the test part. Internal disbonds or delaminations in the material contain small quantities of air and when the air pressure on the part surface is reduced, the test part surface at the location of the anomaly deforms.

7.4.2.6.2.2 Critical for partial vacuum shearography is ensuring there are no leak paths allowing the rapid venting the entrapped gas in the defect within the time frame of the data acquisition. Vented defects will come to equilibrium with pressure changes allowing the surface deformation to relax and the shearography indications to disappear.

7.4.2.6.2.3 Partial vacuum is highly effective for face sheet to core disbonds and delamination in the face sheet. An example in [Figure 7-13](#) is of a carbon fiber panel sandwich with Nomex core measuring 14 x 14 inches inspected using a 1.0 psid load change. Indications are Teflon inserts at plies 4 & 6 as well as between the 8th ply and the adhesive on top of the core.

7.4.2.6.3 Full-Body Vacuum Shearography. The Full Body Vacuum process can inspect the same materials as the partial providing the test article is capable of being placed inside of a vacuum chamber. [Figure 7-14](#) is an example of shearography image recorded using full body vacuum.



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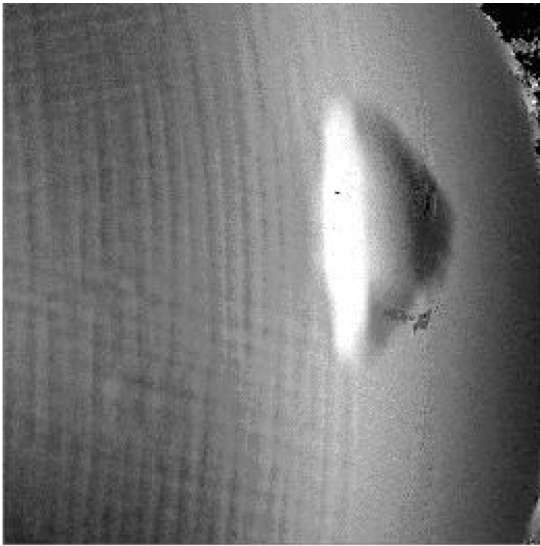
Figure 7-13. Shearography Image of Large (11.4 x 3 ft) Aluminum Honeycomb Aircraft Flap Test in 18 Shearography Tests Using Vacuum Stress

7.4.2.6.4 Pressure Shearography.

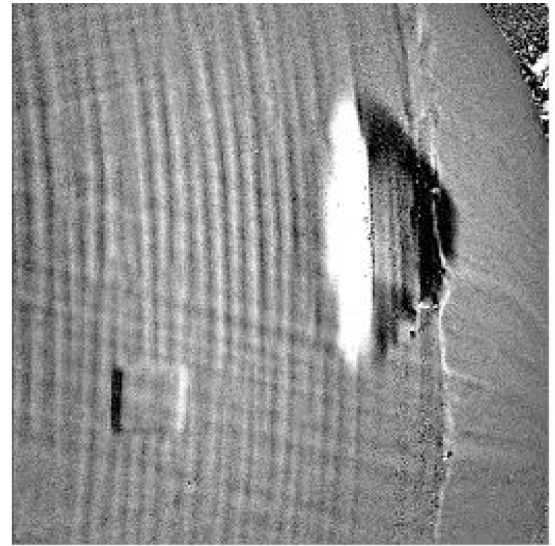
7.4.2.6.4.1 Pressure Shearography provides good results on a wide variety of pressure containing structures including COPV, composite drive shafts, tubular struts, solid propellant rocket motors. Pressure shearography uses a gas to pressurize the test object to between 0.01% to 5% of working pressure. Anomalies that affect the hoop strain or create strain concentrations generate indications of the surface. Test articles are usually placed on a support frame allowing part rotation. Pressure shearography proceeds by capturing reference images and a bias pressure, increasing the pressure to a test level and capturing the stressed data. The vessel can be vented to prepare for the next test.

7.4.2.6.4.2 Shearography data can be taken both during pressurization and venting, if the phase of the data taken during venting is inverted to match that taken during pressurization.

7.4.2.6.4.3 Pressure shearography has also been used to image porosity and poor consolidation of composite tubes and pressure vessels. The tensile loads on the fibers in the hoop and longitudinal directions on tanks create strain concentrations at the site of porosity, voids and poor consolidation. In [Figure 7-14](#), item a, 6.3 inch diameter COPV shearogram is imaged with pressure stress (a) showing the fiber bridging defect only while thermal shearography (b) reveals both fiber bridging and a square Teflon insert.



a. Pressure Shearography



b. Thermal Shearography

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Figure 7-14. Pressure and Thermal Shearography

7.4.2.6.5 Vibration Shearography.

7.4.2.6.5.1 Vibration shearography uses either an air coupled or a mechanically coupled sound source to induced vibrations into the test part in the frequency ranges for the resonance modes of anomalies.

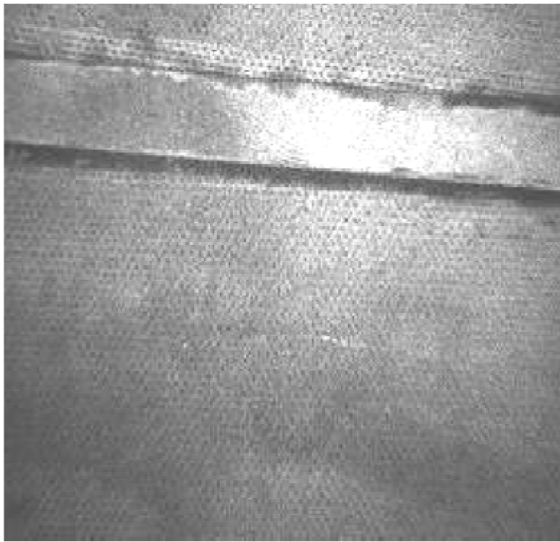
7.4.2.6.5.2 Two types of vibration wave forms have been used:

- a. Sweep frequency
- b. Band width limited white noise

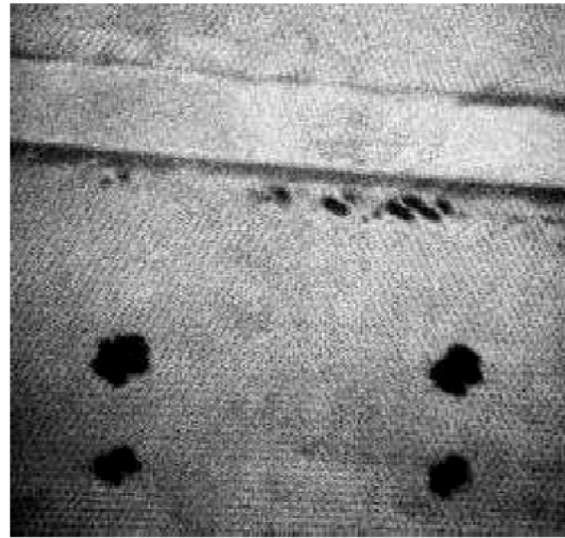
7.4.2.6.5.3 Air Coupled Acoustic Drive (ACAD) should be considered for light weight structures or insulation materials such as honeycomb with thin face sheets and foam insulation used for launch vehicle cryogenic fuel tanks.

7.4.2.6.5.4 Mechanically Coupled Acoustic Drive (MECAD) should be considered for metal to metal bonding, metal honeycomb and structures with perforated face sheets.

7.4.2.6.5.5 [Figure 7-15](#) is an example of an aircraft engine inlet duct with perforated face sheets and honeycomb core. [Figure 7-15](#), item a, is the live image and [Figure 7-15](#), item b, is the shearography image showing natural disbonds and flat bottomed holes. Vibration Shearography is fully real time and the system will operate continuously during data acquisition as the camera scans the test part.



a. live image



b. test result

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Figure 7-15. Perforated Face Sheet Aluminum Honeycomb Shearography

7.4.2.6.5.6 [Figure 7-15](#) shows the perforated face sheet aluminum honeycomb shearography a) live image b) shearography image results with natural disbands and four milled flat bottomed holes from the far side, measuring 0.5 and 0.8 inches in diameter.

7.4.2.6.5.7 MECAD testing is performed using either a clamp-on or vacuum attached vibration exciter. ACAD testing is performed using a speaker with a directional horn. Power levels for ACAD typically are from 250 to 2,000 Watts with sound levels sometimes as high as 125dB. Both ACAD and MECAD can produce sound levels above limits for safe exposure of personnel. The images of disbands will appear at frequencies above most of the structural resonance modes.

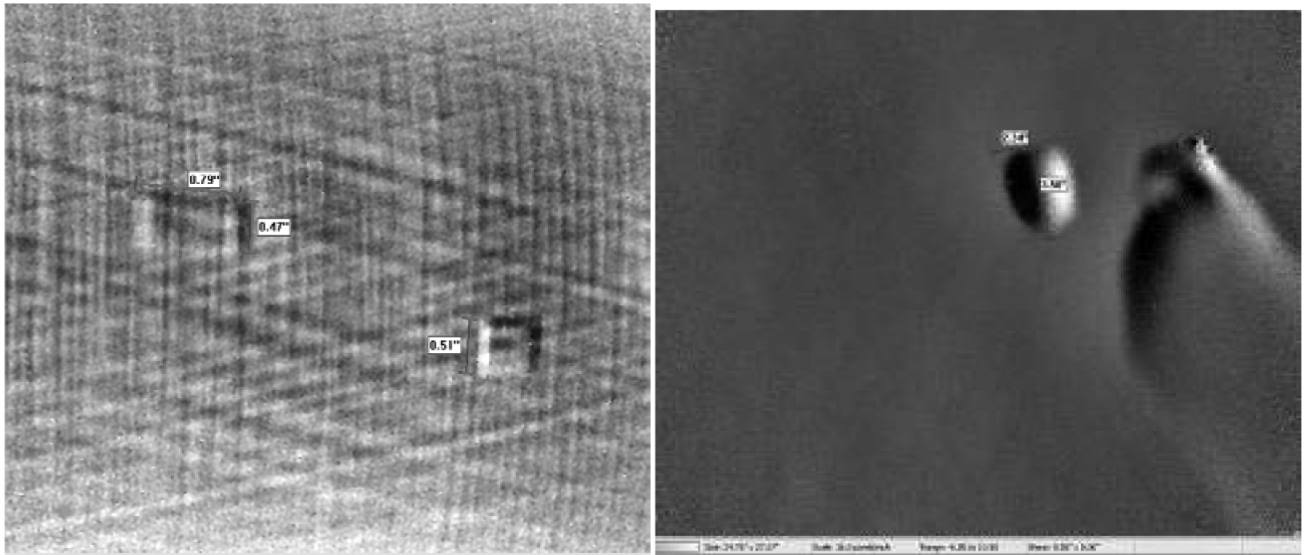
7.4.3 Definition of Defect Indication. NDI often requires an operator to identify defects on a monitor. A definition of a minimum defect indication size, measured in pixels is needed. A single pixel in an entire computer monitor screen cannot practically be detected by an operator and used to define a defect. Camera pixel sensitivity is not uniform and all CCD detectors have missing pixels or pixels with variable electrical response to incoming light. Multiple pixels together having a measurable S/N can be used to define a minimum defect indication. Pixel counts of 5x5 pixels to 12x12 pixels, with S/N greater than 1.1 have been used to define an indication.

SECTION V INTERPRETATION OF LASER SHEAROGRAPHY INSPECTION

7.5 LASER SHEAROGRAPHY INSPECTION IMAGE INTERPRETATION.

7.5.1 Image Interpretation and Analysis.

7.5.1.1 Shearography images provide a straightforward measurement of defect dimensions, S/N ratios, Z-axis deformation, and, for shearography specifically, deformation rate as a function of load change. The computer software does the calculations for the technicians. [Figure 7-16](#) shows dimensional measurements on a shearography image based on the shear vector calibration data and the image scale data. The cosine of the shear vector angle, multiplied by the magnitude of the shear vector is subtracted from the measurement to obtain the actual size. Precision measurements can be made only when an indication is in the center of the camera field of view. Away from the center the test part surface may be at an angle to the camera in one or two axes. As with all full field optical systems, the cosine errors for all axes must be summed to correct the final indication measurements. In practice, the operator may move the defect to the center of the FOV and retest, thereby allowing the precise measurement of the indication.

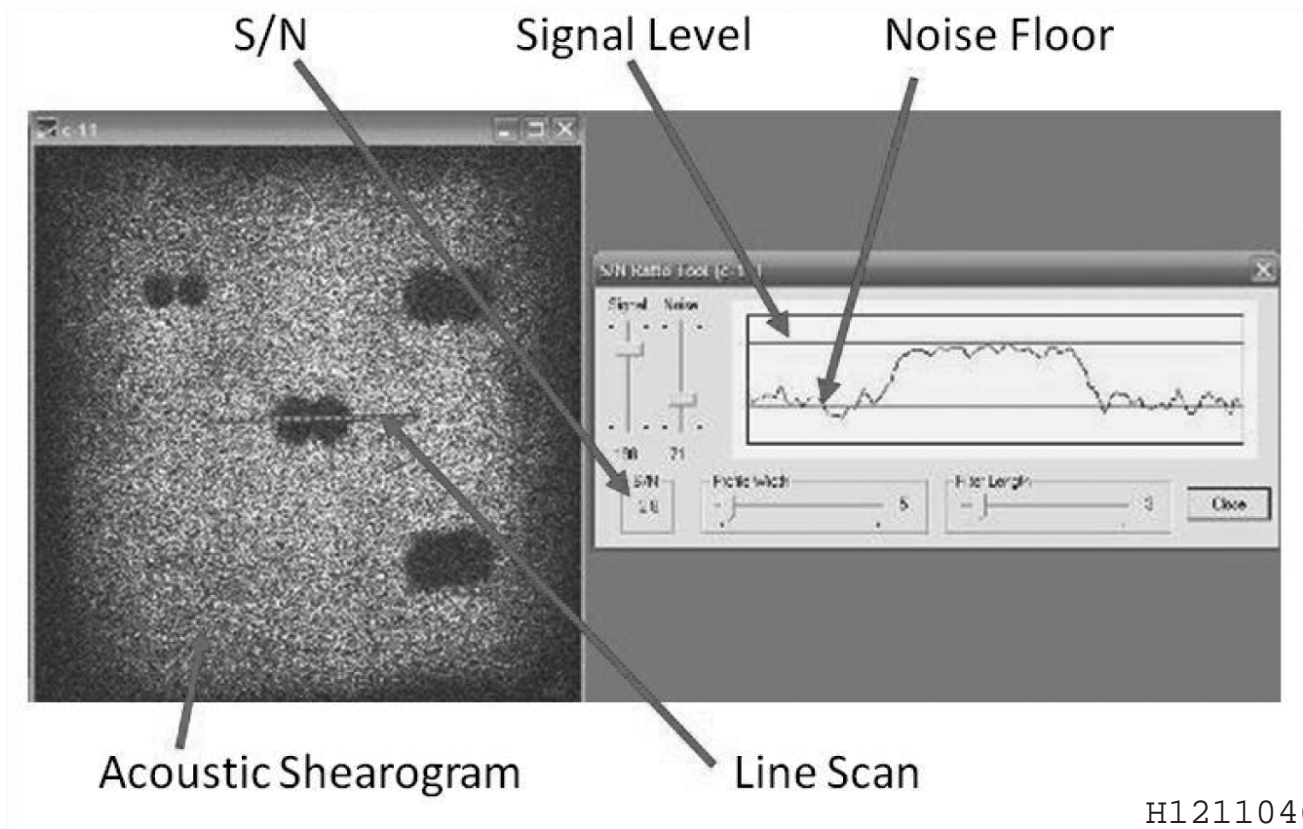


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Figure 7-16. Measurement of Shearography Indications

7.5.1.2 The S/N measurement in the image is very useful for both determining the optimum test method parameters and for quantitative measurements of the signal strength for grading defect indications.

7.5.1.3 The S/N is based on measurements of the pixel grey level in the area adjacent to the defect indication and the peak or average value across the indication. [Figure 7-17](#) shows an example for an acoustic stress shearography image of a foam insulation on a rocket cryogenic fuel tank. The defect S/N ratio will change with the test parameters such as the shear vector, stress change levels, stress method, heating, vacuum levels, vibration excitation frequencies and excitation amplitude. Once the basic shearography method is selected, the S/N can be used to peak the signal strength by adjusting test parameters.



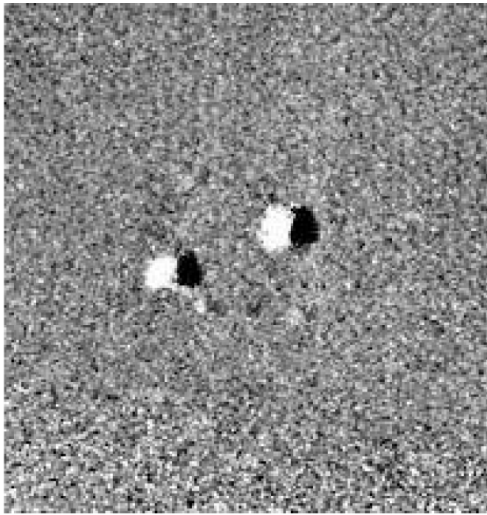
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Figure 7-17. S/N Ratio Measurement of Signal Strength

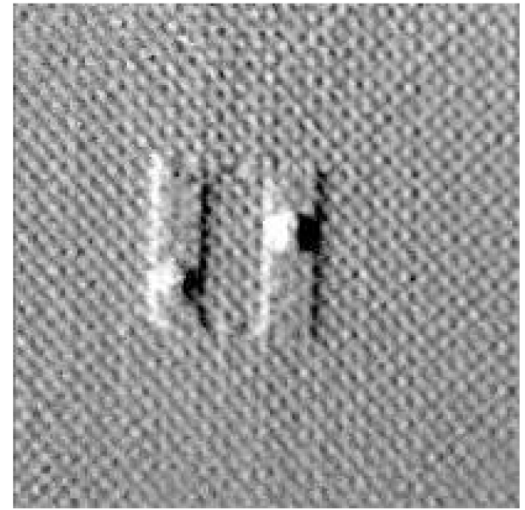
7.5.2 Shearography NDI Test Standards.

7.5.2.1 In shearography and holography, as with all NDI methods, proper NDI test standards are important for the development of the NDI procedure and should be used to determine the correct operation of a system before and after a production test or run, as determined by written practice. It is important to understand the various defect types and characteristics in a given structure and to design NDI standards appropriately. A NDI standard built with Teflon inserts, ideal for simulating foreign material in a composite laminate panel for UT may bond during the panel cure. While UT detects the signal change in through-transmission or a reflection from the Teflon due to the impedance change, this standard may not represent a disbond for vacuum stress shearography, which will only detect actual disbond conditions. Weakly bonded foreign material will not be detected if the elastic bond strength is greater than the applied pressure drop on the surface of the part, usually only in the 0.5 to 2.0 psid range. Thermal stress shearography will detect the insert if the coefficient of thermal expansion (Ct) differs from that of the composite laminate. The thermally induced stresses during shearography inspection in the composite are on the order of 10-500 psi or more depending on the material Ct and the temperature change applied to the part, usually in the 2-20°F range. The mismatch in thermal expansion between the materials is often enough to allow detection of the insert.

7.5.2.2 An example of a carbon laminate panel where vacuum shearography will detect disbands only, while thermal shearography shows Teflon inserts and disbands (Figure 7-18).



a. vacuum shearography

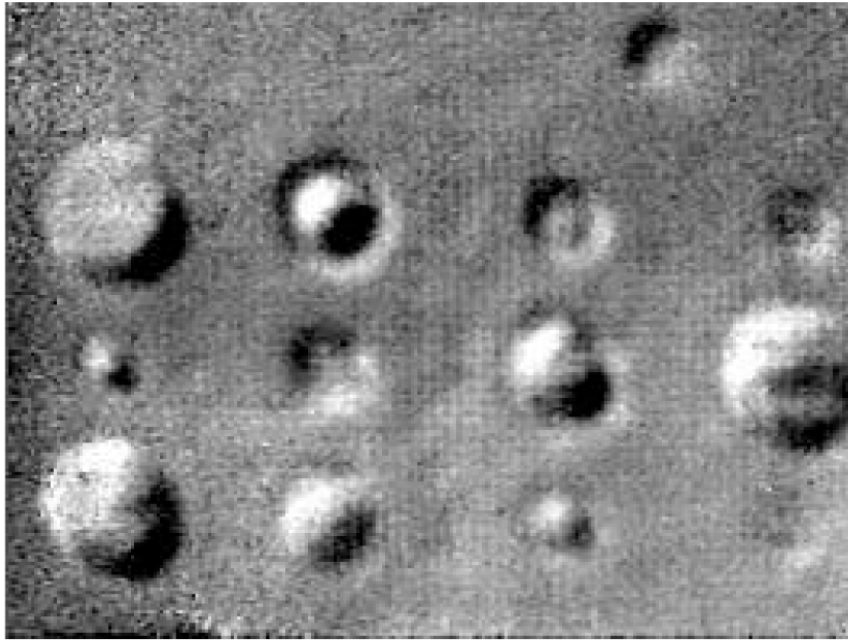


b. thermal shearography

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Figure 7-18. Carbon Fiber Laminate Panel (24 Plies) with Two Teflon Inserts Tested

7.5.2.3 An example of a shearography image of a standard where an end mill was used to simulate disbands at different depths within the panel is displayed in [Figure 7-19](#). The center row of milled flat bottomed holes represent face sheet-to-adhesive failure, the bottom row represents adhesive-to-core failure. A matrix of holes may have different diameters and depths that can be used to create simulations of core-to-adhesive disbands and adhesive-to-face sheet disbands.

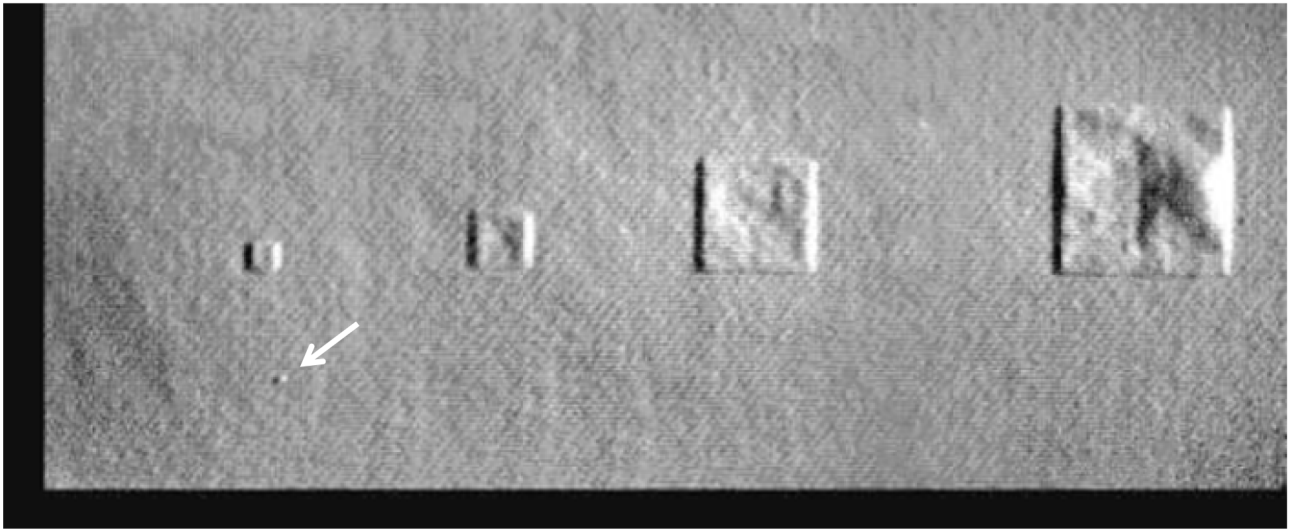


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Figure 7-19. NDI Standard 6 x 8 Inch Composite Sandwich Panel Shearogram with 8 Ply Carbon Fiber Face Sheets and Nomex Core

7.5.2.4 An image of a NDI standard manufactured with carbon fiber face sheets and Nomex honeycomb is displayed in [Figure 7-20](#). The inserts start at 0.25 inches in size. All of the inserts, as well as a very small natural disbond identified by the arrow, are detected with thermal shearography. The small shear vector, $S_v=0.1$ inch @ 0° , provides excellent detail and skin- to-core disbond sensitivity.

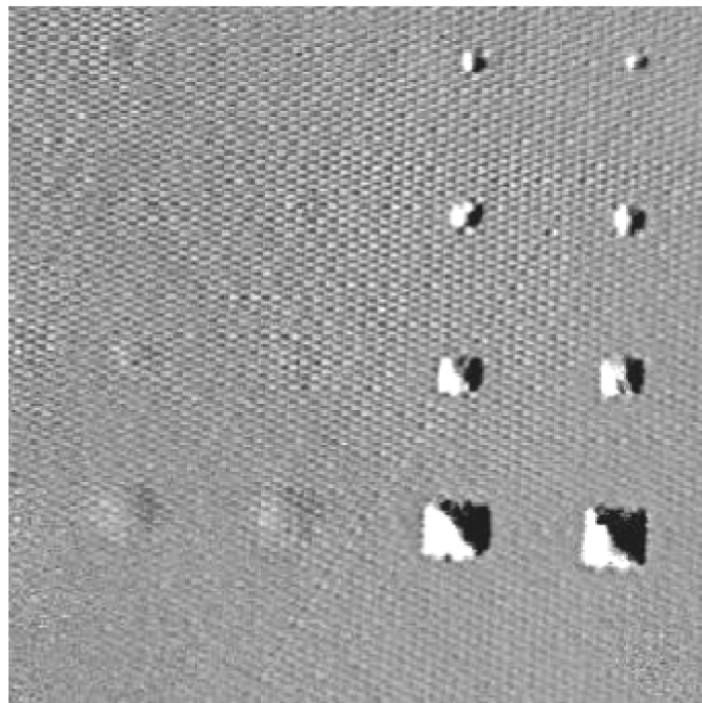
7.5.2.5 The design objective should be to create an artificial defect with known characteristics (diameter, area, depth) that will react the same way as real defects with the same characteristics.



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Figure 7-20. Standard Panel with 5 Ply Carbon Fiber Face Sheets and Nomex Honeycomb

7.5.2.6 A thermal shearography image of a honeycomb NDI standard with carbon fiber skin with aluminum honeycomb using Thermal Shearography mode ([Figure 7-21](#)). Faint indications on the left are Teflon inserts at the far side, while the more pronounced square indications on the right are inserts at the near side skin to core bond line.



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Figure 7-21. Carbon Fiber Skin with Aluminum Honeycomb (Thermal Shearography)

SECTION VI PROCESS CONTROL OF LASER SHEAROGRAPHY

7.6 LASER SHEAROGRAPHY PROCESS CONTROL.

7.6.1 General. For maximum reliability in Shearography, it is necessary to verify the systems capability using a known defect in a reference standard or actual part. The check SHALL be performed prior to component inspection.

SECTION VII LASER SHEAROGRAPHY SAFETY

7.7 LASER SHEAROGRAPHY SAFETY.

7.7.1 Safety Requirements. Safety requirements SHALL be reviewed by the laboratory supervisor on a continuing basis to ensure compliance with provisions contained in AF, NAVAIR, or Army standards and regulations as well as the provisions of this technical order and applicable weapons systems technical orders. Recommendation of the Bioenvironmental Engineering office and the manufacturer regarding necessary personnel protective equipment SHALL be followed.

7.7.2 Laser Safety. Laser shearography non-destructive testing systems utilize laser light to illuminate the surface of a test article being inspected. The laser provides a convenient source of monochromatic-coherent light that makes the implementation of shearography NDI possible. With the exception of extremely low powered laser systems, virtually all laser products pose some form of hazard. The most common hazards associated with lasers come from the direct exposure of the eyes and skin to the laser light itself. Within the United States, laser systems are classified in accordance with the regulations set forth by the Center for Devices and Radiological Health (CDRH) division of the Food and Drug Administration (FDA). Additional Federal, State, and Local regulations may also apply to further regulate the use of a laser product for a given application. Many of these secondary regulations are based on classification data provided by the American National Standards Institute (ANSI). In the European community, laser system standards are overseen primarily by the International Electrotechnical Commission (IEC) and the British Standards Institution (BSI).

7.7.2.1 Laser and "Laser System" classifications are divided into 4 general classifications (Classes 1 through 4) based on levels of increasing hazard. Each of these classifications may in turn have additional sub-classifications (e.g. 1M, 2M, 3a, 3r...) that further define the general hazards associated with a given laser product. Laser classifications are based on the wavelength, output power, and whether the laser has been designed to operate in a continuous (CW) mode or pulsed. Pulsed lasers are designed to release their stored energy in pulses that typically last well under ¼ of a second (femto-second pulses can easily be achieved with the proper laser system). For the purposes of most shearography NDI applications CW lasers are used.

7.7.2.2 General Laser Classifications. There are four classifications for various lasers.

7.7.2.2.1 Class 1 lasers or laser systems are generally considered safe due to their low power or because of the fact that the laser system has been interlocked in such a way as to prohibit operator exposure to laser emissions.

7.7.2.2.2 Class 2 laser systems are generally considered safe under most working conditions as the "blink reflex" (aversion response time) of the human eye will prevent damage in the event of an accidental exposure. Caution should be taken however with regards to the intentional long term direct viewing of this laser light and concentrating the power of the laser light with positive magnification optics such as a telescope or magnifying glass.

7.7.2.2.3 Class 3 laser systems are typically broken down into two categories, low power (CDRH Class 3a/IEC Class 3r) and high power (CDRH/IEC Class 3b) systems. Precautions required for the low powered systems are very similar to those associated with Class 2 lasers but with an increase in allowable power output from 1 mW (Class 2) to 5 mW (Class 3a/3r). Care again must be given to intentional direct viewing of the unexpanded laser light and the use of positive magnification optics to increase the power density of the available light.

7.7.2.2.3.1 Class 3b lasers pose a unique category as they range from relatively safe lasers with outputs slightly above the 5 mW Class 3a/3r requirements, to relatively dangerous lasers with outputs up to 500 mW. Class 3b lasers can easily produce burns to both eyes and skin as power levels increase from about 50-100 mW. The class 3b classification applies to both visible and invisible lasers, thus increasing the potential risk of accidental exposure.

7.7.2.2.4 Class 4 lasers and laser systems are considered hazardous to both eye and skin exposure. Additional hazards with respect to fire and the production of airborne contaminants such as ozone. In addition to the increased hazards, use of Class 4 laser systems is generally very restricted and requires medical surveillance for operators with respect to possible eye exposure.

7.7.2.3 System Classification and Equipment Selection. The classification of a laser system is based on the type and level of exposure an operator would be exposed to during the normal operation and maintenance of their laser system. Based on these conditions, it is very possible that "laser systems" classified as Class 1, Class 2, or Class 3a may contain Class 3b or Class 4 lasers.

7.7.2.3.1 From a practical standpoint, laser systems for shearography NDI systems should be classified so as to provide the most usable system for the operator with the least restrictions. To minimize hazard and restrictions, systems with classification of Class 1, 2, and 3a (3r IEC) are often preferred to those with Class 3b and Class 4 classifications.

7.7.2.3.2 Shearography systems classified as Class 1 and 2 laser systems generally do not require any special safety consideration beyond a basic understanding of the safe use of lasers. Under normal working conditions, Class 3a laser systems extend allowable output emissions of the laser system by 5 times those of Class 2 laser systems without adding additional restrictions beyond a more in depth knowledge of safe laser operation.

7.7.2.3.3 Class 3b and Class 4 laser systems should generally be avoided for all but laboratory systems and controlled environments due to operating restrictions and the need for additional medical surveillance.

7.7.2.3.4 When working with any laser system a few common sense rules of laser safety will go a long ways towards establishing a safe working environment.

7.7.2.4 Rules for Laser Safety. [Table 7-3](#) discusses rules that apply to laser safety. Laser systems classified as Class 1, 2, or 3a may actually contain Class 3b or Class 4 lasers. Bypassing interlocks or modifying system enclosures may allow access to higher levels of laser illumination than that are normally accessible for your certified laser product. Bypassing interlocks or modifying the system is not allowed. Normal eyeglasses are not considered "viewing optics" as they merely correct the natural vision of the human eye and do not increase the concentration of the light being viewed.

Table 7-3. Rules for Laser Safety

	Rule	Comment
1	Never stare directly into the operating laser system or at bright mirror like reflections produced by laser light reflected from metallic or other highly reflected objects.	Intentional extended viewing of both direct and mirror-like reflections can cause injury or blindness.
2	Avoid unnecessary eye exposure to both direct and reflected laser emissions.	Shutter the laser emissions or turn off the laser power when working near the front of the laser system and access to the laser light is not required.
3	Do not leave laser systems powered and unattended, <i>or with personnel not familiar with basic laser safety procedures.</i>	Turn off the laser power, and whenever possible, remove the laser interlock key from Class 3b and Class 4 laser systems to prevent unauthorized access to the operating laser system.
4	Maintain laser emissions within a controlled working area.	Be aware of all stray laser emissions and ensure that they do not pose a hazard to others working nearby.
5	Brief bystanders or observers on the presence of laser emissions and possible hazards.	Never stare directly into the operating laser system or at bright mirror-like reflections produced by laser light reflected from metallic or other highly reflected objects.
6	Do not use viewing optics such as telescopes to view the light from the laser system.	These devices can increase the concentration of the laser light being viewed.
7	Do not disassemble, override, or otherwise modify safety interlocks and sensors for any shearography or holography laser system.	The classification of your laser system is based on operator access during the normal operation and maintenance of your laser system. Modifying the system's optics, interlocks, or enclosures, may invalidate the classification of your laser system.

7.7.3 Thermal Stressing Safety. Thermal stress can be accomplished using high intensity bulbs for short periods of time. All technicians SHALL avoid direct exposure to eyes of the high intensity light. Work areas should be arranged to avoid exposing other technicians in area from exposure whenever possible.

7.7.4 Acoustic Stress Safety Hazards.

7.7.4.1 Hazardous levels of acoustic noise in general are not directly associated with Shearography NDI but may be a by-product of the stressing methods being employed during its application. Sound levels of 130dB have been used for shearography NDI applications using acoustic or mechanical vibration stressing. In the case of acoustic stressing, large compression drivers with focused horns are used to vibrate the test article under examination. Within the United States, noise exposure regulations for general industry are defined by OSHA as documented within 29 CFR 1910.95. According to 29 CFR 1910.95, noise exposure to sound levels 85 dB and above must be regulated through either environmental controls or the use of personnel protective devices such as "ear plugs" or "muffs".

7.7.4.2 Sound pressure levels reference by this standard can be readily measured using inexpensive sound level meters. The measurements are made using an "A-weighted" - "slow response" setting. Limitations as to the permissible time over which an individual can be exposed to increasing levels of noise are defined within table G-16 of standard 1910.95 and range from 8 hr at 90 dBA to 15 min at 115 dBA. Additionally, no exposure to sound intensities greater than 140 dB must be permitted (be especially careful of high intensity sound impulses that may be generated during the impacting of composite samples during the creation of test standards).

7.7.4.3 Due to variations in the application of Acoustic Stressing, a worse case exposure corresponding to the maximum output of the acoustic driver over the expected work period (up to 8 hr/day) should be assumed. Noise protection devices should be selected such as to bring personnel exposure levels to no more than 85 dB over the course of an 8 hour work day. General noise recommendations for acoustic and mechanical vibration stressing:

- Always use the minimum required for the inspection being performed.
- Always assume that the noise source is potentially active unless it has been rendered safe (preferably via the removal of power).
- Be conscious of both operator and by-stander exposure levels! If personnel other than those performing an inspection are present, ear protection should be made available to them.
- Post warning signs outside the "danger area" to warn individual entering the test area of possible high intensity noise exposure.

APPENDIX A

AIR FORCE WIDE FIELD-LEVEL CIVIL SERVICE WRITTEN PRACTICE

A.1 PURPOSE.

This Written Practice establishes requirements and procedures for the qualification and certification of USAF field-level civil service personnel performing Nondestructive Inspection (NDI) in aerospace service, maintenance and overhaul operations. It meets requirements specified by National Aerospace Standard (NAS) 410 Rev 4, NAS Certification & Qualification of Non-destructive Test Personnel, as directed by AFI 21-101, AFI 20-114 and TO 33B-1-1. It addresses the procedural details necessary for the USAF to implement an NDI qualification and certification program and includes, either directly or by reference:

- The levels of qualification and certification used by the USAF
- Personnel duties and responsibilities
- Training and experience requirements
- Certification and recertification requirements
- Records and record keeping requirements
- Requirements for expiration, suspension, revocation and reinstatement of certification

This Written Practice may reference NAS 410 in whole or in part to meet these requirements. It shall be approved by the Responsible Level 3, and shall be available for review by the users' customers and regulatory agencies.

A.2 APPLICABILITY.

This Written Practice applies to field level civil service personnel using NDI methods to test and/or accept materials, products, components, assemblies or subassemblies. It applies only indirectly to depot or AF NDI Office personnel responsible for the technical adequacy of the NDI methods used, who write NDI procedures or NDI work instructions, who audit NDI facilities, who provide technical NDI support or training, or who perform qualification and certification functions. Those depot and AF NDI Office personnel will be qualified and certified in accordance with their own organizations' written practices.

- A.2.1. This Written Practice does not apply to individuals who only have administrative or supervisory authority over NDI personnel, or to research personnel developing NDI technology for subsequent implementation and approval by a certified Level 3. Personnel performing specialized inspections using certain direct readout instruments, as determined by the Air Logistics Complex (ALC) NDI Manager for the applicable weapon system, do not require qualification or certification to this Written Practice.
- A.2.2. Personnel certified to Written Practices developed prior to this document by the various USAF Major Commands (MAJCOMs), or to previous revisions of NAS 410 or EN 4179, need not recertify to the requirements of this Written Practice until their current certifications expire.

A.3 REFERENCE DOCUMENTS.

- AF Manual 33-363, Management of Records
- AFI 21-101 - Aircraft and Equipment Maintenance Management
- AFI 20-114 - Air and Space Equipment Structural Management
- AFSC 2A7X2 Nondestructive Inspection Career Field Education and Training Plan

- NAS 410 (Rev 4) - Certification and Qualification of Nondestructive Test Personnel
- EN 4179 Aerospace Series - Qualification and Approval of Personnel for Nondestructive Testing
- ISO 9712 - Non-Destructive Testing - Qualification and Certification of Personnel
- ASTM E1316 - Standard Terminology for Nondestructive Examinations
- TO 33B-1-1 - Nondestructive Inspection Methods, Basic Theory
- TO 33B-1-2 - Nondestructive Inspection General Procedures and Process Controls

A.4 ORDER OF PRECEDENCE.

In the event of a conflict between the text of this document and the references cited herein, the requirements of this document take precedence. Nothing in this document supersedes applicable laws and regulations unless a specific exemption has been obtained.

A.5 DEFINITIONS OF TERMS.

Terms used in this Written Practice are defined in accordance with NAS 410 and ASTM E1316, unless defined differently herein. In cases where a difference is given herein, the definition as provided in this Written Practice takes precedence.

A.6 RESPONSIBILITY FOR ADMINISTRATION.

The USAF is responsible for the implementation of and compliance with this written practice, and for certifying qualified personnel. The USAF is solely responsible for the certification of its own employees and cannot certify for another employer. Individuals cannot qualify themselves. Responsibility for administering and maintaining all or part of this USAF certification program is as follows.

- AF/A4LM
- AFMC. Per AFI 20-114, AFMC will oversee implementation of NAS 410 for NDI personnel, and will establish and maintain the process for qualification and certification of AF NDI personnel required to be certified IAW the requirements of AFI 21-101 and TO 33B-1-1.
- AF NDI Office (AFLCMC/EZPT-NDIO). As delegated by AFMC, the AF NDI Office will perform functions assigned by AFI 20-114 to AFMC regarding the qualification and certification of AF NDI personnel; and will designate a primary and alternate "Responsible Level 3".
 - Provide Level 3 Examiners to administer NDI qualification examinations to field-level personnel.
 - Act as the "certifier" to formally document personnel certifications once all qualification requirements have been met.
- RESPONSIBLE LEVEL 3. The AF NDI Office shall identify in writing a primary and alternate "Responsible Level 3" to act on behalf of the USAF in matters regarding the NDI qualification and certification process. The Responsible Level 3 shall be certified in accordance with a written practice complying with NAS 410 as a Level 3 in one or more NDI methods and shall have a thorough knowledge of the written instructions, codes, specification and standards used by the USAF. He/she shall also have a thorough knowledge of the materials, components, product technologies, NDI methods and NDI techniques used by the USAF. Additional Examiners will be identified and delegated in writing as necessary to provide coverage for all methods used by USAF field-level civil service personnel. Responsibilities of the Responsible Level 3 include:
 - Responsible for the implementation of NAS 410 and this written practice and the overall administration of the qualification and certification program.
 - Designate Examiners as necessary to provide coverage for all methods, and to administer examinations and other portions of the qualification program as assigned.

- Designate Instructors of NDI training courses (also see [Paragraph A.10.8](#)).
- Verify that training provided by Outside Agencies meets the USAF's requirements.
- Determine the equivalence of previous training obtained by personnel previously certified under other recognized NDI qualification programs to the requirements of NAS 410 Table I and the training outlines referenced in this document.
- Maintain overall control and cognizance over the NDI training program, including designating or approving qualified Examiners, Instructors, or Outside Agencies.
- Approve previous and/or equivalent experience obtained by candidates with previous employers.
- Evaluate any limitations in candidates' color perception prior to certification and approve in writing.
- Determine reference materials to be provided with administration of Specific and Practical exams.
- Develop/approve checklists to administer and grade Practical exams.
- Determine and document how Practical examination results are to be documented.
- With designated Examiners, administer and grade all examinations:
 - Delegate in writing administration/grading of exams using multiple choice or true/false questions to non-Examiner personnel;
 - With Examiners, administer all practical exams;
 - Evaluate responses to essay and fill-in questions to verify candidate's adequate understanding of the subject matter.
- AFSC Air Logistic Complexes (OC-ALC, OO-ALC & WR-ALC). Consistent with availability of Examiner resources, provide Examiners to administer qualification examinations.
- NDI MAJCOM Functional Manager (MFM):
 - Serve as liaison between field-level NDI laboratories and the AF NDI Office and AFSC depots to communicate requirements and assist with arrangements for scheduling and accomplishing qualification of field-level civil service NDI technicians.
- USAF Field Level NDI Laboratory Supervisor:
 - Serve as liaison between the civil service NDI technician, the MFM, and the AF NDI Office, to identify and communicate requirements for certification testing, and to acquire and submit necessary records documenting technicians' visual acuity, training, and experience qualifications.
- NDI Technician. Perform functions as specified in the Personnel Duties and Responsibilities section, in NDI methods and techniques for which they are qualified and certified.
- Outside Agency. The USAF may use a Level 3 certified in accordance with NAS 410 from an outside agency to examine NDI personnel or perform any other qualification Level 3 function. An outside agency may qualify, but not certify personnel. The Responsible Level 3 shall document the suitability of any outside agency selected to perform any function in meeting the requirements of this written practice. This documentation shall be of sufficient detail to justify the outside agency's ability to perform the required Level 3 function(s).

A.7 METHODS AND TECHNIQUES.

This Written Practice contains detailed requirements for qualification and certification in the following common NDI methods and associated techniques. Not all techniques are applicable to all operating locations, so technicians will only be required to qualify and certify in the techniques utilized where they are assigned.

- Liquid Penetrant Testing (PT), including the following techniques:
 - Water Washable, Method A
 - Solvent Removable, Method C
 - Post Emulsifiable (Hydrophilic), Method D

- Magnetic Particle Testing (MT), including the following techniques:
 - Stationary Equipment
 - Portable Yoke and Permanent magnets
- Eddy Current Testing (ET), including the following techniques:
 - High Frequency ET
 - Rotary Fastener Hole ET
 - Low Frequency ET
 - Magneto Optical Imaging
- Ultrasonic Testing (UT), including the following techniques:
 - Longitudinal wave UT
 - Shear and surface wave UT
 - Bond testing
 - Phased array
- Radiographic Testing, (RT), including the following techniques:
 - Film X-ray
 - Computed Radiography

A.8 OTHER METHODS.

When invoked by engineering, quality, cognizant engineering organization or prime contractor requirements, this Written Practice may be expanded to apply to other current and emerging NDI methods used to determine the acceptability or suitability for intended service of a material, part, component, sub-assembly or assembly. Such methods may include, but are not limited to, acoustic emission, neutron radiography, leak testing and holography. The requirements for personnel training, experience and examination for these other methods shall be established in accordance with NAS 410 [Paragraph 6.4](#) through 6.4.2 and shall be documented by the Responsible Level 3.

A.9 LEVELS OF QUALIFICATION AND CERTIFICATION USED.

The four levels of certification identified per NAS 410 are Level 1-Limited, Level 1, Level 2 and Level 3. NAS 410 allows the employer to subdivide, add or limit levels as appropriate, but cannot eliminate or reduce the minimum requirements for each level. The USAF will only qualify and certify field level civil service personnel to Level 2 in accordance with this Written Practice. NDI personnel shall not independently perform the functions listed below if not certified to the appropriate level in the applicable technique/method. (See [Paragraph A.15](#) for further information.)

- Trainee: An individual who is documented as participating in a training program for an NDI method and is in the process of becoming qualified for certification to Level 2 shall be considered a trainee. In the technique/method in which they are preparing for certification, trainees shall:
 - Be documented as a trainee and be actively participating in a training program for a stated NDI method for a limited and specified period of time.
 - Obtain experience under the direct observation of a Level 2 or qualified military trainer in the same method.
 - Not make accept or reject decisions.
 - Not independently conduct tests.
 - Not independently perform any other NDI function other than process controls if properly trained and documented.

- When prior USAF military NDI technicians are hired as civil service NDI technicians by field level units, those personnel may initially perform inspections once qualified by the unit per the AFSC 2A7X2 CFETP program for a maximum period of nine months, after which they must be qualified and certified IAW this written practice to continue performing inspections.
- Level 1 - Limited: USAF field level civil service personnel will not be certified to Level 1 - Limited.
- Level 1: USAF field level civil service personnel will not be certified to Level 1.
- Level 2: In the method in which certified, Level 2 individuals shall:
 - Have the skills and knowledge to set up and standardize equipment, process parts, interpret and evaluate for acceptance or rejection, and document results.
 - Be thoroughly familiar with the scope and limitations of the technique/method.
 - Have the skills and knowledge to conduct system performance checks in accordance with the applicable process standard.
 - Be capable of providing the necessary guidance and/or supervision to trainees.
 - Be familiar with the codes, standards, and other contractual documents that control the method as used within assigned duties.
 - Be capable of developing work instructions from approved general procedures.
 - Have a basic knowledge of relevant product manufacturing and inspection technology.
 - Have a basic knowledge of aircraft maintenance.
- Level 3: Level 3 individuals providing services per this Written Practice shall be certified by their employing USAF organization, in accordance with a Written Practice which complies with NAS 410. USAF field level civil service personnel will not be certified to Level 3.
- Auditor: USAF field level civil service personnel will not be certified as auditors.

A.10 TRAINING REQUIREMENTS.

Candidates for certification to all levels shall complete sufficient formal training to become proficient with the principles and practices of the applicable test method and technique(s) and be capable of carrying out the specified duties and responsibilities. Formal training shall be completed prior to, or in conjunction with on-the-job training (OJT). All completed NDI training shall be documented.

NOTE

Formal training and OJT is NOT the same thing, and OJT is NOT to be counted as formal training.

A.10.1 Preferred Formal Training Courses. Since most civil service NDI technicians employed at field level locations are prior-service USAF personnel, the formal training obtained from AETC via the USAF AFSC 2A7X2 NDI Career Field Education and Training Plan (CFETP) will be used to the maximum extent possible to fulfill formal training requirements.

- USAF Nondestructive Inspection Apprentice course JCABP2A732 048B or equivalent
- USAF AFSC 2A7X2 Nondestructive Inspection CFETP 5-Level Career Development Course
- USAF AFSC 2A7X2 Ultrasonic Inspection and Impedance Plane Analysis course JCAZP2A752 OU1A
- USAF Nondestructive Inspection Craftsman course J3ACP2A772 000 or equivalent

Air Force Training. Prior United States Air Force military personnel who received their formal training while in the NDI career field, AFSC 2A7X2, may be used to satisfy the formal classroom training requirements, provided satisfactory proof of this training has been provided. However, the upgrade training (UGT) is often self-paced so actual determination of hours

may be difficult. Determining the equivalency of candidates AF training is the responsibility of the Responsible Level 3 for personnel qualified under the AFSC 2A7X2 career field. Documentation will include a copy of the AF NDI Schoolhouse training certificate, CDCs, 623's etc. A copy will be placed in the employee's qualification records. Personnel who have completed this schooling will be required to take a general, specific, and practical examination for each applicable method that certification is sought. Other official courses provided by AETC or through field training detachments (such as ET courses for the F-22, PW- 220 or PW-229) will be considered for fulfillment of this requirement.

A.10.2 Pre-Approved Alternate Formal Training. Formal NDI training courses obtained at the Air Logistics Complex depots are approved substitutes for the AETC courses per the NDI CFETP, for the applicable NDI method and Level.

A.10.3 Other Alternative Training. Personnel who have not completed either the USAF AETC Formal NDI training courses or the depot NDI training may substitute alternative training obtained from previous employers or commercially available sources.

- Alternative training obtained from other sources must meet the minimum formal training hour requirements of NAS 410 ([Table A-1](#) and [Table A-2](#)).
- Alternative training must be conducted in accordance with a detailed course outline, and include all topics specified in NAS 410, paragraph 6.1.1.
- Alternative training shall include 24 hours of industrial radiation safety training if formal training was not AETC formal NDI training.
- If alternative training sources are used to fulfill training requirements, sufficient documentation will be submitted for the Responsible Level 3 at the AF NDI Office to verify that the training meets USAF requirements.

Table A-1. Minimum Formal Training Hours for Level 2

Method	Level 2 without previous Level 1 certification
PT	32
MT	32
ET	80
UT	80
RT film or nonfilm	80
RT film and nonfilm	120

Table A-2. RT Formal Training Hours for Transition to Film and Nonfilm

Additional Formal Training Hours
Current Level 2
40

A.10.4 General, Specific and Practical Training. General, specific and practical training may be obtained with the USAF, a previous employer or an Outside Agency, but shall always be supplemented with practical on-the-job training (OJT) with the employing field unit.

A.10.5 Training Outlines. All training shall be conducted in accordance with a detailed course outline approved by the Responsible Level 3 and including all topics specified by NAS 410, [Paragraph 6.1.1](#).

- Outlines for AETC administered NDI training courses are maintained by the AF NDI Technical School, Det 1, 359 TRS, Pensacola NAS FL.
- Outlines for AFSC depot-level NDI training courses are maintained by AFSC/ENSI, Tinker AFB OK.

- Outlines for alternative training courses obtained from previous employers or commercially available sources must be submitted to the AF NDI Office (AFLCMC/EZPT-NDIO) for Responsible Level 3 verification that NAS 410 and USAF requirements are complied with.

A.10.6 Previous Training. For personnel credited with previous training, or personnel not certified within 12 months of their FORMAL training, refresher training must be provided.

- As a minimum, refresher training shall cover products, equipment set-up, operation and standardization, specific operating procedures, applicable techniques, interpretation and evaluation of NDI results, safety, and applicable codes, standards and specifications.
- Refresher training will be provided by the employing field unit utilizing an OJT format and will include items in the AFSC 2A7X2 CFETP.

A.10.7 Equivalent Training. For personnel previously certified under NAS 410, EN 4179 or other recognized NDI qualification programs, the adequacy and equivalency of their previous training to the requirements of NAS 410 Table I/IA and the outlines referenced in this Written Practice shall be determined and documented by the Responsible Level 3, AF NDI Office.

A.10.8 Training and Examination Personnel. The Responsible Level 3 shall maintain overall control and cognizance over the NDI training program, including designating or approving qualified Examiners, Instructors, and Outside Agencies.

- Examiners: When necessary, Examiners will be designated in writing by the Responsible Level 3 and shall be certified per NAS 410. As determined and documented by the Responsible Level 3, an Examiner can prepare, administer and grade written or practical NDI examinations and administer all or part of the certification process in the method in which certified.
- Instructor: Instructors shall have the skills and knowledge to plan, organize and present classroom training and practical exercises IAW approved course outlines, and shall be designated or approved by the Responsible Level 3. Those personnel assigned and designated as instructors by AETC at the NDI Technical Schoolhouse or for field training detachments, and at the depot Air Logistics Complexes, are recognized as also being approved and designated to provide training to field level personnel in accordance with this written practice.
- Outside Agencies: When an outside agency is used, the outside agency shall provide the USAF with the names, evidence of qualifications and, if applicable, evidence of certifications held by the personnel conducting the training and examination.

A.11 EXPERIENCE REQUIREMENTS.

Candidates for initial certification to Level 2 shall have sufficient practical experience to assure they are capable of performing the duties of the level for which certification is sought. The minimum experience requirements (in hours) for Level 2 is provided in NAS 410 (Tables A2-1 and A2-2).

A.11.1 On-The-Job Training (OJT). For the purpose of gaining experience, OJT shall be conducted by personnel certified in accordance with this written practice or a military trainer qualified per the AFSC 2A7X2 CFETP and AFI 36- 2201, and may be counted toward fulfillment of experience requirements.

A.11.2 Previous Experience. A candidate's experience with a previous employer may be accepted by the USAF only if such experience is documented and approved by the Responsible Level 3.

Table A-3. Minimum Experience Hours Requirements for Level 2

Method	Level 2
PT	400
MT	530
ET	800
UT	800
RT film or nonfilm	800
RT film and nonfilm	1000

Table A-4. RT Experience Requirements for Transition to Film and Nonfilm

Additional Minimum Experience Time in Hours
Current Level 2
200

A.11.3 Equivalent Experience. For personnel previously certified under NAS 410, EN 4179 or other recognized NDI qualification program, the adequacy and equivalency of their previous experience to requirements of NAS 410 Tables II and IIA ([Table A-3](#) and [Table A-4](#)). shall be evaluated and documented by the Responsible Level 3.

A.12 EMERGING NDI METHODS.

The minimum required training and experience hours for methods that may come into use by the USAF that are not listed in NAS 410 Tables I/IA or II/IIA ([Table A-1](#) and [Table A-2](#) or [Table A-3](#) and [Table A-4](#)) shall be established by the Responsible Level 3, in accordance with guidance in NAS 410 paragraph 6.4.1.

A.13 EXAMINATION PRACTICES.

Examinations to verify technical qualifications of candidates shall include a general, specific and practical examination for each method in which the candidate is to be certified. Examinations and test samples shall be made available to candidates only during administration of the examinations.

A.13.1 Vision Examination. An examination for visual acuity shall also be conducted prior to the candidate's first certification and periodically thereafter. The vision examination for Level 2 personnel shall assure that the applicant's near vision and color perception meet the requirements of NAS 410, [Table A-5](#). Vision requirements do not apply to instructors or auditors. Near vision tests shall be administered annually and color perception tests shall be administered at least every 5 years. Visual examinations shall be administered by qualified medical personnel at the field level bases' medical facilities. When vision correction is necessary to pass the visual acuity exam, vision correction shall be worn during all testing/inspections. Any limitations in color perception shall be evaluated by the Responsible Level 3 prior to certification and must be approved in writing.

Table A-5. Vision Requirements

Examination Requirements	
Near Vision	Jaeger #1 at not less than 12" (30.5 cm)*, 20/25 (Snellen) at 16" (40.6 cm), ±1" (2.54 cm)*, or Tumbling E IAW ISO 18490
Color Perception	Personnel shall be able to adequately distinguish and differentiate colors used in the process involved

A.13.2 General Examination. The general examination shall be a closed book written examination covering the cross-section of the applicable method at the appropriate level. A minimum of 40 written questions shall be administered for the general examination at Level 2. A few additional questions will usually be included to ensure at least 40 questions remain in the event that a subsequent audit should disallow use of one or more questions.

A.13.3 Specific Examination. The specific examination shall be an open book written examination covering the requirements and use of the specifications, codes, equipment, operating procedures and test techniques the candidate may use in the performance of his/her duties with the USAF. A minimum of 30 written questions shall be administered for the specific examination at Level 2. A few additional questions will usually be included to ensure at least 30 questions remain in the event that a subsequent audit should disallow use of one or more questions. Reference material such as specifications, tables, formulas, etc. will be provided as determined by the Responsible Level 3 or Examiner. Questions utilizing reference materials shall require understanding of the information contained therein rather than merely finding its location.

A.13.4 Practical Examination. The practical examination shall consist of a demonstration of proficiency in performing tasks that are typical of those to be accomplished in performance of the candidate's duties. If the candidate is required to demonstrate proficiency in the application of the process as well as interpretation of results, hardware test samples shall be used. The location and severity of flaws in the test sample shall not be apparent to the candidate. If the candidate is only required to interpret the results and not perform the process of generating the image, the test samples may be images, such as radiographs or other resultant test data. A written checklist covering the topics detailed below shall be developed and completed by the Responsible Level 3 or Examiner to assure adequate coverage and to assist in the administration and grading of the examination. In addition to using the checklist, the responsible Level 3 or Examiner shall determine and document how the examination results obtained by the candidate are to be documented (e.g. part maps, drawings, sketches, written descriptions, etc.). All such documentation shall become part of the examination and filed accordingly.

- Level 2 Practical Examination: The candidate shall demonstrate proficiency by inspecting at least 2 test samples of differing configurations for each method, with at least one test sample for each technique for which certification is sought. When only one configuration is to be inspected upon certification, both test samples may be of the same configuration. The test samples shall meet the definition in NAS 410 paragraph 3.33 and shall be representative of the products to be encountered by the candidate in the performance of his/her duties with the USAF. The candidate shall document the NDI results in accordance with the applicable acceptance criteria. The checklist shall include proficiency in the use and standardization of equipment and materials, adherence to procedural details, and the accuracy and completeness of interpretation and evaluation of indications.

A.14 ADMINISTRATION OF EXAMINATIONS.

The administration and grading of all examinations shall be the responsibility of the Responsible Level 3 or Examiner assigned to the AF NDI Office. Administration and grading of general or specific examinations using multiple choice questions may be delegated to non-Examiner personnel. All practical examinations and responses to essay and fill-in questions shall be administered by the Responsible Level 3 or Examiner. In no case can an examination be administered by one's self or by a subordinate.

A.14.1 Administration by an Outside Agency. If an Outside Agency is used to administer examinations, the USAF will ensure that all individuals involved in the administration of the examinations meet the requirements of this written practice.

A.14.2 Scoring of Examinations. The candidate for certification must achieve a minimum score of 70% on each examination. In addition, the candidate must detect all discontinuities, flaws or conditions specified by the level 3 during the practical exam and achieve a minimum score of 70%. The candidate must have an average score of no less than 80% for the General, Specific and Practical examinations in order to be eligible for certification. All examination scores shall be of equal weight in determining the average score. Scores for ASNT, or ISO 9712 NDT certificates scored as pass/fail and used in lieu of a general examination shall be assigned a value of 80%.

- For practical examinations consisting of two or more techniques and specimens, each technique and specimen will be treated individually regarding the requirements to detect all discontinuities, flaws or conditions and to achieve a minimum score of 70%, then the various practical components will be combined into a single score for averaging in with the general and specific exam scores.

A.14.3 Re-Examination. Candidates failing any general, specific or practical examination shall receive additional training before attempting re-examination of the failed exam. The additional training shall be documented and shall address those areas found deficient in the candidate's skills or knowledge. The re-examination shall not use the same written tests or test samples used in the initial examination. The re-examination test must contain a minimum of 25% new questions. No more than two attempts may be made for any particular exam within a single calendar week.

A.15 CERTIFICATION AND RECERTIFICATION REQUIREMENTS.

Personnel who have met all the appropriate qualification requirements are eligible for certification by the USAF in accordance with this written practice. Certification is not required for trainees, instructors, auditors or personnel performing specialized inspections using direct readout instruments. The process for obtaining certification is as follows:

A.15.1 Trainee Activities Prior to Certification. Until a field-level civil service NDI technician has completed sufficient formal NDI training and experience per the requirements of NAS 410 and this Written Practice, they will be considered a trainee, and their activities will be limited to those listed in the Duties and Responsibilities section of this written practice. NDI Laboratory supervisors or NCOICs will provide trainees with additional training and experience as appropriate until minimum qualification requirements are met.

A.15.2 Records Submission. When trainees have completed all formal training, experience and visual acuity examination requirements, field-level NDI laboratory chiefs will forward records of those qualifications to their MFM and to the AF NDI Office (email to aflcmc-ezpt-ndio@us.af.mil) with a request that the technician be scheduled for certification examinations.

A.15.3 Records Review. Upon receipt of the candidate's documented training, experience and visual acuity examinations, the AF NDI Office will review that documentation to ensure all applicable qualification requirements have been fulfilled. Any documentation packages determined to not meet all qualification requirements will be returned back to the applicable MFM and NDI Laboratory Supervisor or NCOIC with instructions for resolution. If all qualifications are satisfactory, the candidate will be approved to be scheduled for certification examinations.

A.15.4 Scheduling of Certification Examinations. The AF NDI Office will coordinate with the field level unit (courtesy copy MFM) to schedule an available Examiner and time for the administration of certification examinations to the candidate technician.

A.15.5 Logistics Considerations. Field level units or MAJCOMs will provide necessary travel funding for their technicians' TDY travel and per diem to the applicable facility for certification testing. In some circumstances, if multiple technicians require examination from the same base, it may be more cost effective for a Level 3 Examiner to travel to that base than for the technicians to travel to the AF NDI Office. In that event, the field level unit or MAJCOM will provide the necessary funding for the Level 3 Examiner's travel and per diem, and will ensure availability of all necessary personnel, facilities, equipment and materials to support the examination process.

A.15.6 Administration of Certification Examinations. The candidate technician or Examiner will travel to the applicable facility (AF NDI Office or field unit) for certification testing. The Examiner or delegated proctor will administer the applicable general, specific and practical examinations to the candidate. Certification testing will usually include five NDI methods, and will take a minimum of one full week. In some cases if re-examination is needed, additional time may be required.

- If a prior USAF NDI technician operating temporarily as a trainee IAW the AFSC 2A7X2 CFETP attempts an NAS 410 certification examination under this written practice, and fails to pass in that attempt, that technician will be decertified in that NDI method by their unit under the CFETP until they can successfully pass NAS 410 certification.

A.15.7 Recording of Results. The Examiner will record the examination results on the practical exam checklists, enter individual examination results and the composite (average) score on an AFMC IMT 74, NDI Personnel Qualification and Certification Record, and sign the AFMC IMT 74 in the "Qualification Approved By" column for those methods where satisfactory scores have been achieved, then return the AFMC IMT 74 and checklists to the AF NDI Office.

A.15.8 Certification of Results. The AF NDI Manager will sign the AFMC IMT 74 in the "Certification Approved By" column for those methods where satisfactory scores have been achieved, insert a date at the end of the month five years in the future in the "Date Expires" column, and forward copies of the results and IMT 74 back to the MFM and the field level NDI Laboratory Supervisor or NCOIC.

A.15.9 **Records.** The field-level unit and the AF NDI Office will maintain personnel certification records in accordance with AFMAN 33-363, Management of Records and disposed of IAW Air Force Records Disposition Schedule. Keep records as long as the certification is in effect or per records disposition schedule, whichever is longer. Records to be maintained shall include:

- Name of the certified individual.
- Level, method, and technique(s) for which individual is certified.
- The latest written and practical examinations and the AFMC IMT 74 with results from the immediately previous exams. (Examinations themselves will be maintained by the AF NDI Office, and records of results will be kept by field units.)
- Date and expiration of current certification(s).
- NDI training history that identifies the source, type of training, dates of training, course hours, and, if applicable, the documentation of Responsible Level 3 approval of the adequacy and equivalency of previous and/or equivalent training.
- NDI experience history, including any previous certifications, both with current and previous employers, sufficient to justify satisfaction of experience requirements for qualification, and, if applicable, the documentation of Responsible Level 3 approval of previous and/or equivalent experience.
- Results of the most-recent (i.e. current) visual acuity and color perception examinations. (Visual acuity records submitted for initial qualification will be kept by the AF NDI Office, while ongoing annual vision exam records will be maintained by the field units.)
- The name and signature of the USAF representative authorizing the certification (the AF NDI Manager).

A.15.10 **Record Availability.** All training, qualification and certification records shall be maintained IAW this Written Practice and shall be made available for audit by the facility's customers or regulatory agencies. All such records, except for actual examinations, shall be made available to the applicable employee upon request or upon leaving the unit.

A.15.11 **Loss of Certification.** NDI certifications may expire, be suspended or revoked.

A.15.11.1 **Expiration.** Certifications for all levels shall expire when the certification interval has lapsed with no recertification issued. Certification for all levels is considered to expire at the end of the corresponding month 5 years from which the certification began.

A.15.11.2 **Suspension.** Certification shall be suspended when the visual acuity examination is overdue, the individual does not perform in the method certified for at least 12 consecutive months, failure of a recertification examination, annual maintenance is expired, or when the individual's performance is found to be deficient in any manner. Examples of deficient performance include but are not limited to failure to pass a periodic Personnel Evaluation under the Quality Assurance program, documented failure to find a defect, or disregard of established procedures. Suspension will be accomplished by the unit NDI Laboratory Chief, or may also be done by the Chief of the AF NDI Office.

A.15.11.3 **Revocation.** Certification in a certified method shall be revoked when the individual does not perform in the method for the USAF for at least 24 consecutive months or USAF employment is terminated. Certification in all methods shall be revoked when the individual's conduct is found to be unethical or incompetent.

A.15.12 **Reinstatement of Certification.** Certifications that have been suspended may be reinstated up to the original certification date when the cause has been corrected and the correction verified by the unit's NDI Laboratory Chief (notify AF NDI Office) or the individual's proficiency is verified by the Responsible Level 3 or Examiner. Certifications suspended due to overdue eye exams may be reinstated by the NDI Laboratory Supervisor or NCOIC when a new eye exam is successfully completed. Certifications that have been suspended due to failure to perform in the method for at least 12 months can only be reinstated via reverification of proficiency (administration of practical exam) by the Responsible Level 3 or Examiner. Certifications that have expired or been revoked may only be reinstated by General, Specific and Practical examination equivalent to initial certification..

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A.15.13 Recertification. Personnel certified to this written practice shall be recertified at intervals not to exceed five years. Recertification shall be accomplished by successful completion of General, Specific and Practical examinations equivalent to those required for initial certification.

A.15.14 Annual Maintenance. Annual maintenance for Level 2 personnel shall be conducted as a practical examination by a designated Examiner or an individual personnel evaluation (IPE) by an authorized quality assurance individual for each method of certification. Successful annual IPEs IAW AFI 21-101 satisfies this requirement. The practical examination or IPE should evaluate the individual's ability to demonstrate proficiency in the method and evaluate/interpret results. Demonstration with known defect samples is preferable and observation during an actual inspection being acceptable. Process controls from T.O. 33B-1-2 or calibration of instrumentation SHALL NOT be used to fulfil this requirement.

A.15.14.1 Documentation. Documentation of pass/fail IPEs will be forwarded to the AF NDI Office for certification record updates. Entries may be made on the example form, [Figure A-1](#), AF Form 1098, or equivalent.

A.15.14.2 Annual Maintenance Re-examination. Failure of the annual maintenance results in immediate suspension of certification. Additional training shall be conducted and documented prior to re-examination or a second IPE. The re-examination shall not use the same test samples or IPE task previously used in the initial examination or IPE.

APPENDIX B

RADIOGRAPHY TECHNIQUE DEVELOPMENT PROTOCOL FOR USAF AIRFRAME CRACK DETECTION APPLICATIONS

B.1 PURPOSE.

The following protocol shall be used to develop radiographic techniques using film or Computed Radiography (CR) for fatigue crack detection. This practice has been demonstrated¹ to achieve the capability documented in EN-SB-08-012 Rev D for fatigue crack detection in aluminum plate up to 0.375 inches thick within aluminum structures of 1.125 inches total cross-sectional thickness, or in steel plate up to 0.25 inch thick with up to 0.25 inch of additional aluminum structure. Use outside of this range of applications has not been validated or verified.

B.2 APPLICABILITY.

This protocol is **ONLY** for use by USAF depot level NDI personnel responsible for developing radiography inspection procedures for airframe crack detection. It is recommended that these personnel have completed all pertinent training on the use of the respective method (film or CR), are cognizant of standard radiographic principles, and are familiar with the operation of the film or CR system in use. All appropriate radiation safety procedures shall be in place and operative.

NOTE

Detection of cracks that are a result of overload (i.e. long and wide cracks), or detection of a severed component are applications that are expected to be significantly easier to detect than fatigue cracks. In those instances, this protocol is not required but may be used as a guide. It is recommended that an on-aircraft verification be performed to demonstrate the visibility of representative damage in the area of interest (i.e. to assess the effects of radiation scatter and/or nearby structural features that could obstruct the required view). Representative damage may be simulated with a cracked part or by placing the same thickness (or thicker) worst-case crack specimen from the Radiography Technique Development Kit RTDK ([Figure B-1](#)) in the region of interest on the aircraft.

B.3 GENERAL REQUIREMENTS.

This protocol prescribes general technique development requirements for fatigue crack detection using film or CR, along with the materials and equipment listed below ([Table B-1](#) and [Table B-2](#)) and in this document. If conditions exist that are not adequately covered, contact the appropriate authority. For Air Force units contact AFRL/RXSA.

Table B-1. Consumable Materials

Nomenclature	Specification/Part No.	CAGE Code
Class II Film	See TO 33B-1-1	
Computed Radiography Imaging Plates	See TO 33B-1-2 WP 106 01	
Hole Type IQI Set	ASTM E1025	
Wire IQI Set (optional)	ASTM E747	

Table B-2. Applicable Support Equipment

Part Number	Nomenclature	Figure Number
6635-01-394-5926	X-Ray Inspection Unit or approved equivalent	
See TO 33B-1-2 WP 106 01	Computed Radiography Reader	
See TO 33B-1-2 WP 106 01	Computed Radiography Workstation	
RTDK	Radiography Technique Development Kit	Figure B-1

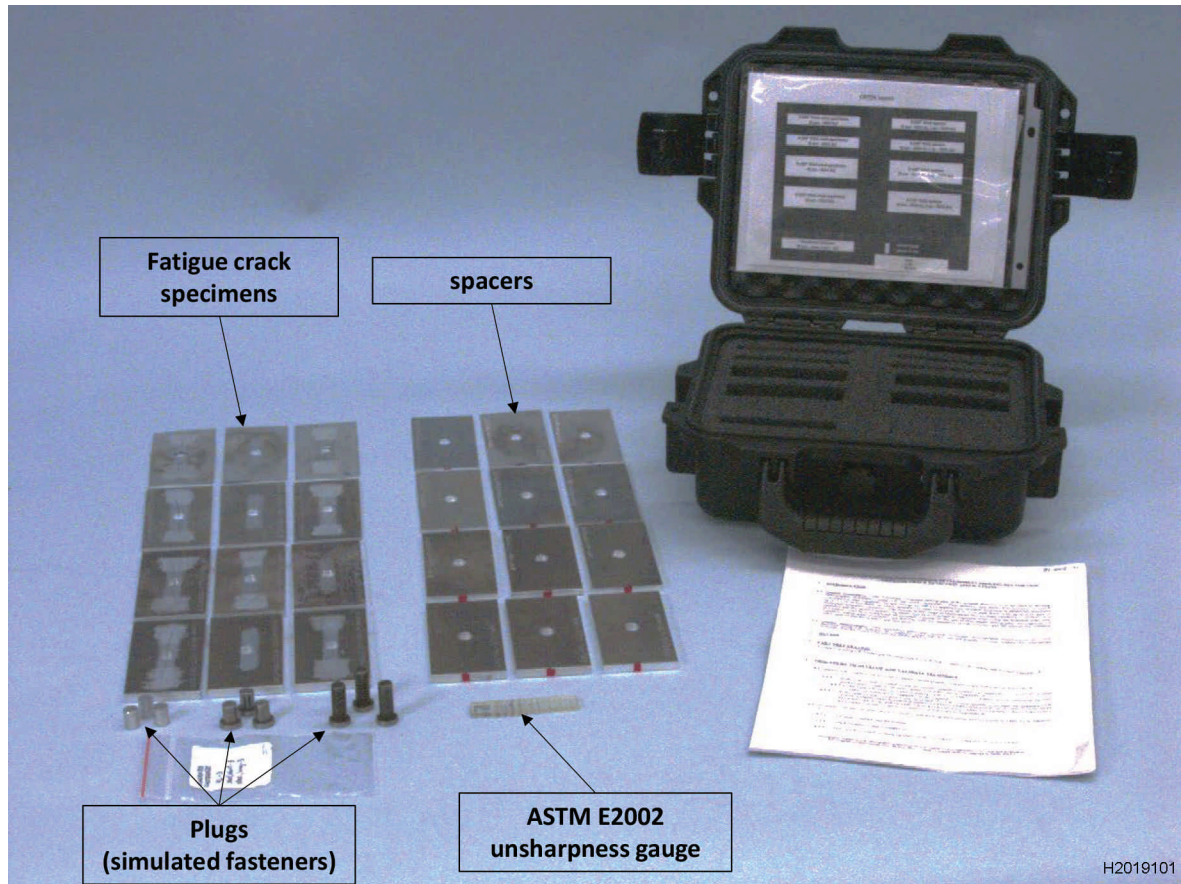


Figure B-1. Radiography Technique Development Kit, RTDK

B.4 VERIFY RADIOGRAPHY SYSTEM PERFORMANCE.

B.4.1 . Computed Radiography System Performance.

B.4.1.1 The CR system used for technique development shall be listed in TO 33B-1-2, WP 106 01 Table 4, “CR Systems Qualified for Crack Detection”. Document in B.9 Record.

B.4.1.2 Perform CR Process Control testing IAW TO 33B-1-2, WP 106 01. Record spatial resolution (lp/mm) values in B.9 Record. These values will be used in [Paragraph B.6.6.3](#).

B.4.2 . Film Radiography System Performance – Perform process control testing IAW TO 33B-1-2, WP 106 00.

B.5 ESTABLISH PRELIMINARY TECHNIQUE PARAMETERS.

B.5.1 . Determine structure cross section and stack-up thicknesses of the region of interest and document in B.9 Record.

B.5.1.1 Materials and thicknesses of each layer in the cross-section.

B.5.2 . Determine the Object-to-Detector Distance (ODD) as the distance (to nearest 0.50 inch) from crack plane to the detector (imaging plate (IP) or film) and document in B.9 Record. See [Figure B-2](#).

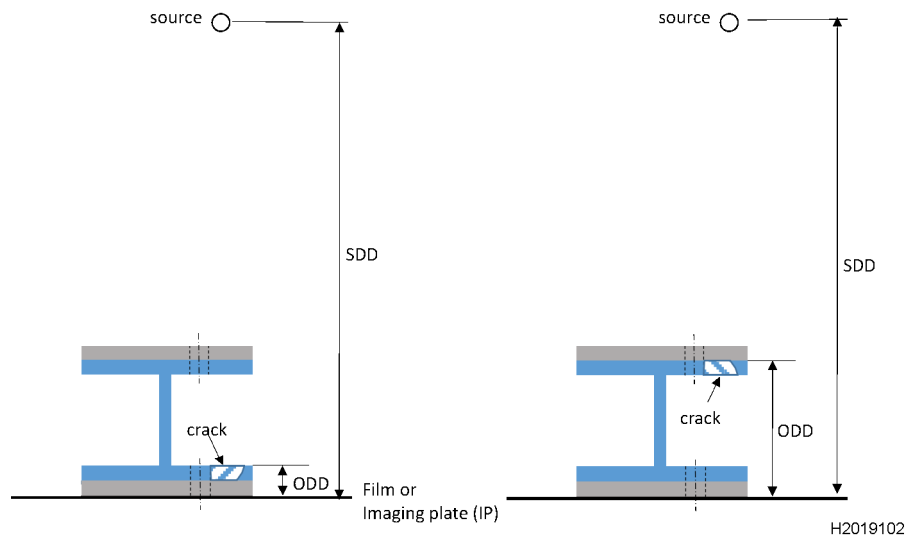
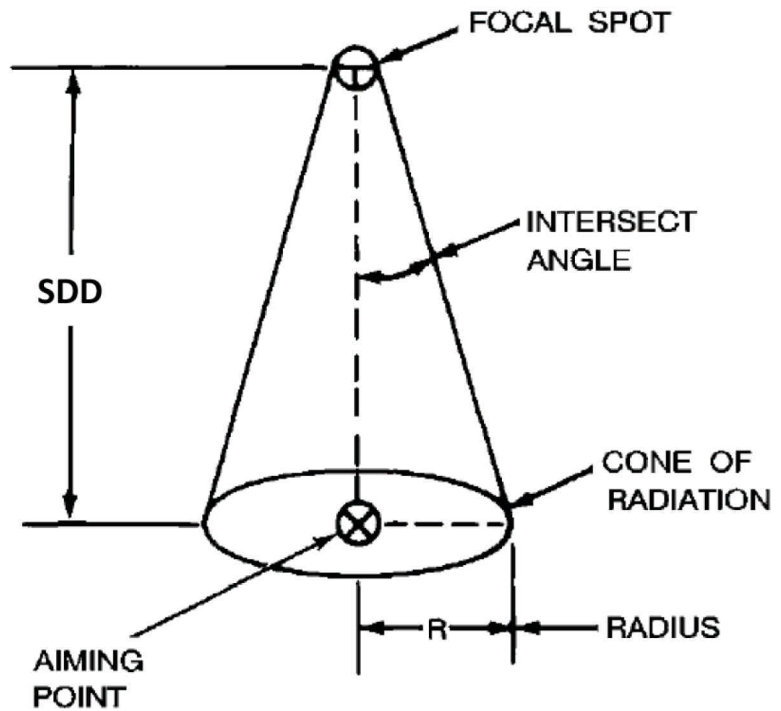


Figure B-2. Examples of ODD Measurement

B.5.3 . Determine the optimum Source-to-Detector Distance (SDD) as that which satisfies ALL of the factors in [Paragraph B.5.3.1](#) through [Paragraph B.5.3.3](#):

B.5.3.1 Select the minimum SDD to achieve the required inspection area per exposure (i.e. larger SDD = larger area of interest) and document in B.9 Record. See [Figure B-3](#).

SDD, source to-detector distance (inches)	radius of inspection area within radiation cone (inches)	
	for crack layer thicknesses ≤ 0.250 inch (5° intersect angle)	for crack layer thicknesses > 0.250 inch ≤ 0.375 inch (2.5° intersect angle)
12	1.0	0.5
24	2.1	1.0
36	3.1	1.6
48	4.2	2.1
60	5.2	2.6
72	6.3	3.1
84	7.3	3.7
96	8.4	4.2
108	9.4	4.7
120	10.5	5.2



For more information, see B.10 Supplemental Information

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Figure B-3. Required Minimum SDD Based On Cone Of Radiation And Desired Area Of Coverage

B.5.3.2 Determine the minimum SDD required for the ODD (from Paragraph B.5.2) of the technique being developed and document in B.9 Record. See Table B-3

Table B-3. Required Minimum SDD for a given ODD

ODD (inch)	≤ 1.00	1.50	2.00	2.50	3.00	3.50	4.00	4.50	5.00	5.50	6.00	6.50	7.00	7.50	8.00
SDD (inch)	10.9	16.3	21.7	27.1	32.6	38.0	43.4	48.8	54.3	59.7	65.1	70.6	76.0	81.4	86.8

*Based on 1.5mm focal spot (Lorad 160KVP tube); For other focal spot sizes, see B.10 Supplemental Information

B.5.3.3 Using the larger of the SDD selected in Paragraph B.5.3.1 and Paragraph B.5.3.2, verify that the SDD is feasible based on access and/or to accommodate common support equipment (e.g. X-ray tube stands). If the SDD must be reduced to make inspection feasible, consider reducing the inspection area covered by each shot using Figure B-3.

B.5.3.4 Document final SDD and final radius of inspection area (using final SDD and Figure B-3) in B.9 Record.

B.6 MOCKUP.

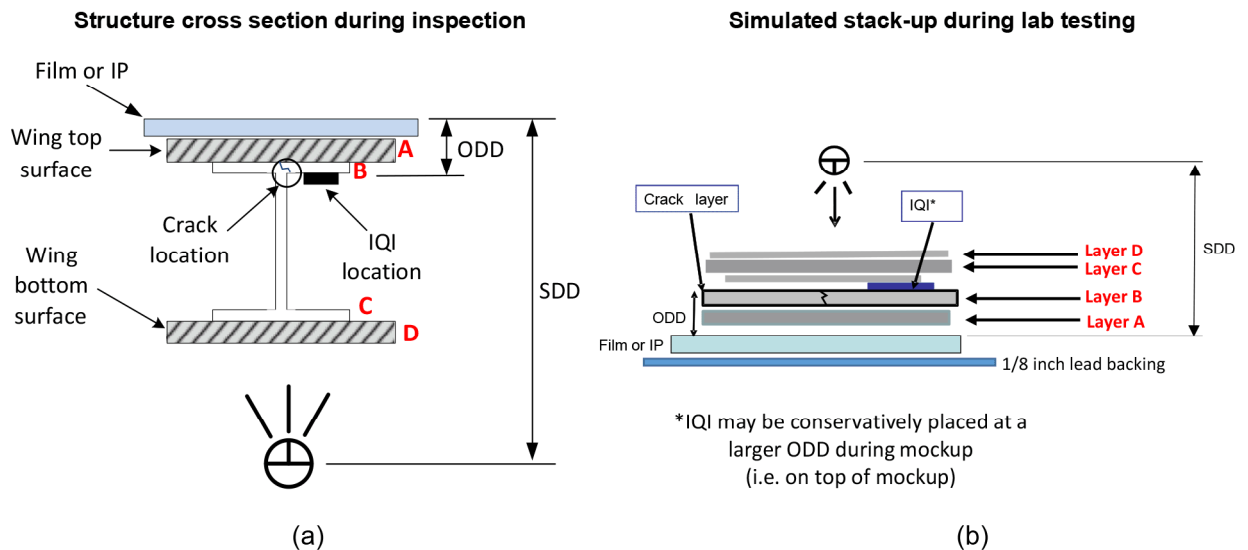
NOTE

- The mockup, using representative materials and thicknesses, serves as a means to verify the required unsharpness (which is designed into the [Table B-3](#) values) and to simulate crack detection which may not be practical during the on-aircraft verification. It also provides an opportunity to optimize the technique prior to gaining access for on-aircraft verification. If similar to previous documented mockups, the mockup requirement can be documented as “satisfied by similarity” in B.9 Record.
- Actual components with representative flaws may be used in-lieu of cracked panels provided in the RTDK.

B.6.1 . Assemble three mockups of the actual aircraft structure. For convenience, the contents of the RTDK may be used for this purpose. The RTDK contains spacers, crack specimens, and an ASTM E2002 unsharpness gauge. If using the RTDK, each of the three mockups should contain one of the three crack types provided in the RTDK (short tight crack, long tight crack, long wide crack). Each of the three mockups should be assembled as follows (see [Figure B-4](#)):

B.6.1.1 Each “uncracked” layer in the actual aircraft structure region of interest shall be represented by spacers of the same material as the actual aircraft structure, of equal or GREATER thickness.

B.6.1.2 The crack layer (i.e. the layer representing the cracked structure) shall be represented by crack specimens of the same material as the actual aircraft structure, of equal or LESSER thickness. Distance from the crack layer to the IP shall be the same or greater than the ODD established in [Paragraph B.5](#).



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Figure B-4. Schematic Cross Sections of (a) Actual Inspection Component and (b) Simulated Mock-Up Used in Technique Development

B.6.2 . Place the mockups on top of the detector (IP or film) and cassette. A minimum of 1/8 inch lead backing (i.e. behind the cassette) shall be used to prevent backscatter in the lab environment. See [Figure B-4](#).

NOTE

Crack orientation can affect detection especially near the edge of the cone of radiation where alignment is worst case. Worst case crack orientation is parallel to the radiation cone because the width of the crack blurs in the radiograph.

B.6.2.1 Each mockup should be placed at worst case alignment and orientation for the inspection (i.e. at the edge of the cone of radiation). See [Figure B-5](#).

B.6.2.2 Place the IQI(s) on or within the simulated mockup. The IQI(s) shall represent a thickness equal to or LESS than the total stack-up thickness in the beam path.

NOTE

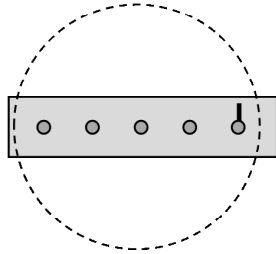
A wire type IQI (ASTM E747) may be used in lieu of a hole-type IQI for the on-aircraft technique. If this is the case, the mockup shall include both types of IQIs. The smallest wire that is visible when the required 2-2T hole is visible, shall be the required wire for the on-aircraft technique. See B.10 for wire type IQI selection information.

B.6.2.3 Place the ASTM E2002 gauge at the aiming point and at the same plane as the crack layer. A separate spacer or spacers may be placed under the gauge if necessary. Spacer material should be the same as the specimens.

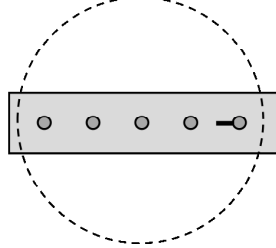
B.6.3 . Document the mockup layout in B.9 Record.

Inspection Application

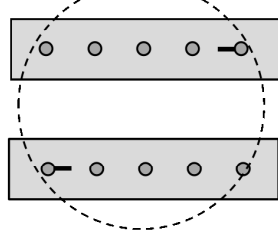
Cracks oriented parallel to radiation cone



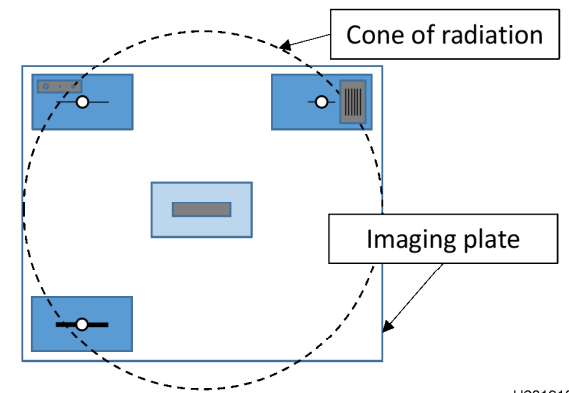
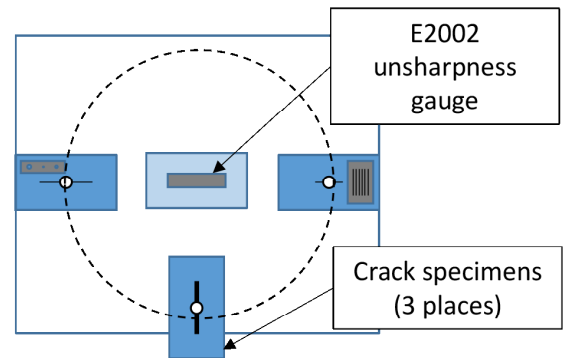
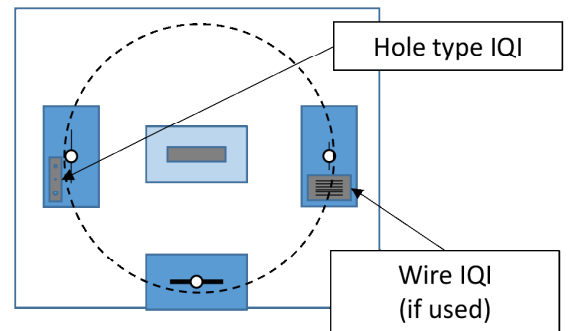
Cracks oriented perpendicular to radiation cone



Cracks over a wide-inspection area



Mockup Layout



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Figure B-5. Placement Of Mockups And Gauges

B.6.4 . Determine the approximate exposure parameters.

B.6.4.1 Determine the minimum exposure (mA and time) for the SDD selected in [Paragraph B.5.3.3](#), using [Table B-4](#).

Table B-4. Minimum Exposure required based on SDD

Minimum Exposure required based on SDD			
SDD (inches)	mA	sec	mA-sec
12	1*	20*	20
18	3*	20*	60
24	5*	20*	100
30	5	27	135
36	5	39	195
42	5	54	270
48	5	70	350
54	5	89	445
60	5	109	545
66	5	132	660
72	5	158	790
78	5	185	925
84	5	214	1070
90	5	246	1230
96	5	280	1400
102	5	316	1580
108	5	354	1770
*For short exposures, mA is reduced instead of time to ensure X-ray tube has enough time to reach the required kV			
For other SDD values, see B.10 Supplemental Information			

B.6.4.2 Determine the energy (kV). See [Table B-5](#) for an approximate kV.

B.6.4.2.1 (CR only) Sufficient energy is achieved when the 2T hole is visible on the IQI, and the pixel value (PV) in the area of interest is within the allowable PV range documented in TO 33B-1-2 WP 106 01 Table 6 for the specific CR system being used for the test.

B.6.4.2.2 (Film only) Sufficient energy is achieved when the 2T hole is visible on the IQI, and the film density in the area of interest is between 1.5-4.0.

NOTE

- (CR only) Some manufacturer’s cassettes contain lead screens (back only or front and back). Ensure the presence and thickness of lead screens are documented (in B.9 Record).
- The responsible level 3 may reduce the PV (CR) or film density (film) range requirements of the final procedure if desired (i.e. increase the minimum and/or decrease the maximum).
- Lead screens within cassettes are recommended for energies above 90kV (5 mil front screen, 10 mil back screen or per the manufacturer’s recommendation).
- If the PV or film density is too high, decrease kV.
- If the PV or film density is too low, increase kV and/or increase time.
- In no case should the exposure (mA x sec) be decreased below the minimum exposure defined in [Paragraph B.6.4.1](#).
- If the required T-hole is not visible, increasing exposure (mA x sec) may help. This may require reducing kV to maintain the required PV.

Table B-5. Approximate kV For Various Aluminum Thickness When Using The Exposure Parameters Of Table B-4

Total Aluminum Section Thickness (inches)	Approximate kV
<0.25	40
0.25-0.50	50
0.50-0.75	60
0.75-1.0	70
1.0-1.5	80
1.0-1.5	90-100*
*with Pb front screen	

B.6.5 . Take exposure and record all technique parameters and image quality metrics in B.9 Record.

B.6.6 . Acceptance criteria for initial technique.

NOTE

Visibility of the 3 types of fatigue cracks (short tight crack, long tight crack, long wide crack) does not establish an inspection capability, but provides an estimate of the type of fatigue crack that may be detectable. In all cases, the long wide crack shall be detectable. In most cases, the long tight crack should be detectable.

B.6.6.1 (CR only) The PV in the region of interest shall be within the allowable PV range documented in TO 33B-1-2 WP 106 01 Table 6 for the specific CR system.

B.6.6.2 (Film only) The film density in the region of interest shall be between 1.5-4.0.

B.6.6.3 The 2-2T hole shall be visible on the IQI in the radiograph. If a (ASTM E747) wire-type IQI was also used, record the smallest visible wire in B.9 Record.

B.6.6.4 (CR only) Determine the required ASTM E2002 duplex wires (image unsharpness, U_{im}) using the spatial resolution established in [Paragraph B.4](#) (see [Table B-6](#), [Figure B-6](#)). Determine the U_{im} achieved as the E2002 wire pair that is clearly resolvable in the image of the ASTM E2002 gauge in the radiograph.

B.6.6.5 (Film only) The #10 wire (or smaller) shall be visible on the ASTM E2002 duplex wires.

Table B-6. (CR Only) Required E2002 Wire Pair For CR System Used For Technique Development And Validation Testing

Spatial Resolution Of CR System As Measured In Step B4.2 (lp/mm)	Required Image Unsharpness, U_{im} As Measured Using ASTM E2002 Gauge (wire pair #)
6.0-7.0	#9
8.0-10.0	#10
See B.10 for more information on U_{im}	

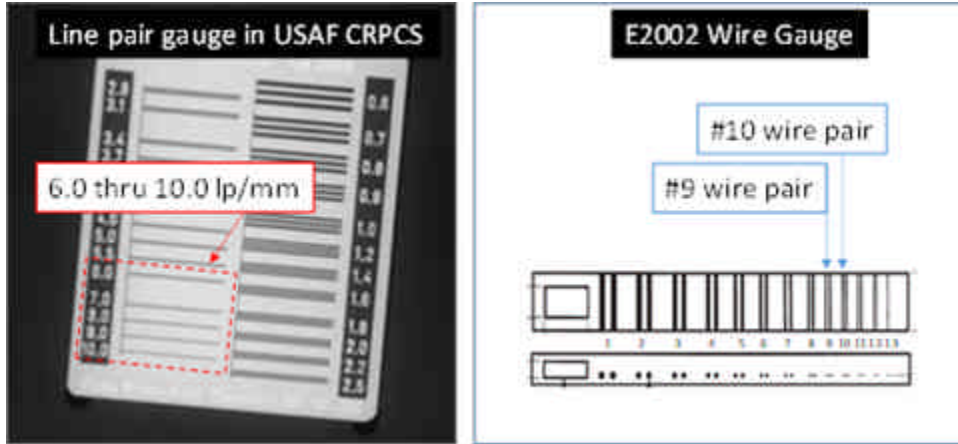


Figure B-6. Line Pair Gauge Used In Process Control And Unsharpness Gauge Used In Mockup

B.6.7 . Document test information in Appendix B2 Record.

B.7 ON-AIRCRAFT VERIFICATION OF TECHNIQUE.

NOTE

On-aircraft verification shall be performed on-aircraft or using components closely simulating the on-aircraft configuration.

B.7.1 . (CR only) The CR system used for on-aircraft verification testing must be listed in TO 33B-1-2 WP 106 01 Table 4 “CR Systems Qualified for Crack Detection”. TO 33B-1-2, WP 106 01, Table 6, “Technique for EPS Test and Allowable Pixel Value Ranges” lists the allowable PV range. Document system details in B.9 Record.

NOTE

- If the Fuji Dynamix HR2 was used to develop the technique ([Paragraph B.5.](#)), the exposure (mA or sec) shall be DECREASED by a factor of 0.75 for use with any other CR system.
- If a system other than Fuji was used to develop the technique ([Paragraph B.5.](#)), the exposure (mA or sec) shall be INCREASED by a factor of 1.25 for use with the Fuji Dynamix HR2.

B.7.2 . Technique verification shall be conducted on the actual aircraft structure of interest. All adjacent aircraft structures and systems should be in a representative configuration as what will be required for the actual inspection.

B.7.2.1 Position a hole-type IQI (or wire IQI) within the imaging area, and shim as required to achieve the same total thickness (or greater) as the area of interest. The PV (CR) or the film density (film) on the IQI shall be the same or less than that in the area of interest. The IQI may be located on the same side of the structure as the imaging plate since it is only being used to confirm penetration. Record the location and shim information for technical order documentation.

B.7.2.2 If practical, place the crack specimens (used in the simulated mock-up in [Paragraph B.6](#)) in a position that results in the crack specimen having a PV (CR) or film density (film) equal to or LESS than the region of interest. Shims may be used to add thickness to the region with the specimens. Multiple crack specimens may be placed on the structure at once if they are within the radiation cone as determine in [Paragraph B.6](#).

NOTE

- Depending on placement and thickness of the crack specimens, the total thickness of the region with crack specimens may be significantly thicker than the region of interest.
- If the crack specimens and areas of interest cannot meet pixel value requirements in same exposure), either 1) use thinner crack specimens, but repeat [Paragraph B.6](#) mockup tests using these thinner specimens to ensure results are comparable to the specimens originally used, or 2) the crack specimens may be omitted from the on-aircraft validation.

B.7.3 . Using technique established in [Paragraph B.6](#), take on-aircraft exposures and record results in B.9 Record.

B.7.4 . Acceptance criteria for on-aircraft verification test.

NOTE

If technique adjustment is required to satisfy the acceptance criteria below, kV may be adjusted as necessary but mA and/or time may only be INCREASED from the values established in development testing.

B.7.4.1 (CR only) Measure PV in the thickest (i.e. lightest) and thinnest (i.e. darkest) regions within the area of interest and confirm the PV is within the PV range defined for the system in use per TO 33B-1-2 Table 6 for Crack Detection. If the PV is not within allowable limits, adjust kV and/or time and repeat the exposure.

B.7.4.2 (Film only) Measure the film density in the thickest (i.e. lightest) and thinnest (i.e. darkest) regions within the area of interest and confirm that the film density is between 1.5-4.0.

B.7.4.3 Measure the PV or film density on the IQI and confirm that the measurement is the same or less than that measured in the area of interest above. If the PV or film density is higher add shim material and repeat the exposure.

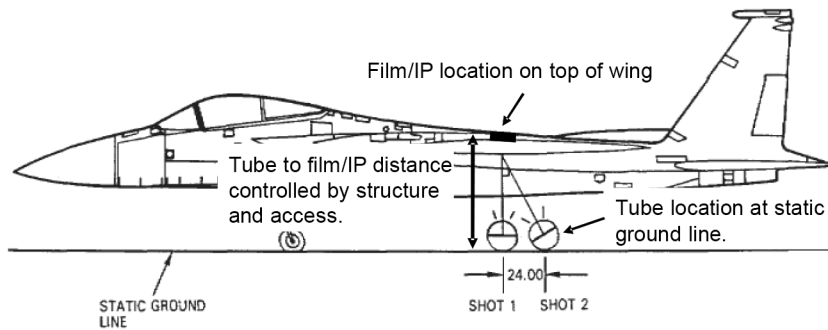
B.7.4.4 Confirm that the outline of the IQI is visible and the 2T hole is detected. If not, adjust kV and/or time and repeat the exposure.

B.7.4.5 Compare crack detectability on-aircraft to mockup (if applicable). If on-aircraft results are inferior to mockup, consider repeating on-aircraft exposure using a backscreen of lead (5 mil or thicker) to reduce possible effects of scatter and/or re-evaluating with a more representative mock up.

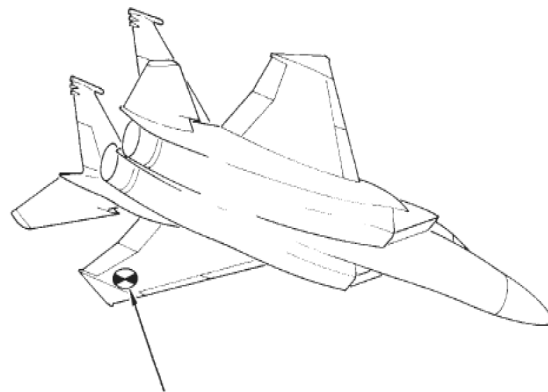
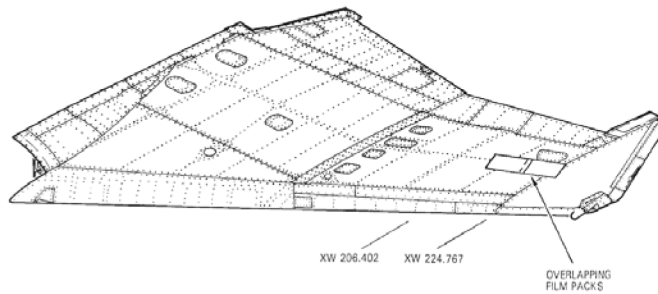
B.7.5 . Document results in B.9 Record.

B.8 TECHNICAL ORDER DOCUMENTATION.

B.8.1 . A series of sketches of the aircraft showing detector (IP or film) and X-ray tube placement locations, and aiming point(s) shall be provided. ([Figure B-7](#)).



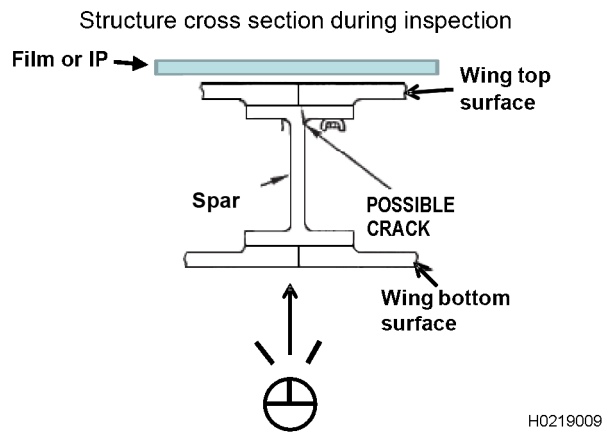
Focus to film/IP distance established with tubehead at static ground line and oriented to 90 ° from wing lower surface for aiming point.



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Figure B-7. Example Detector (IP or Film) Placement Locations and Aiming Point Relative to Aircraft Structure for Radiography Inspection

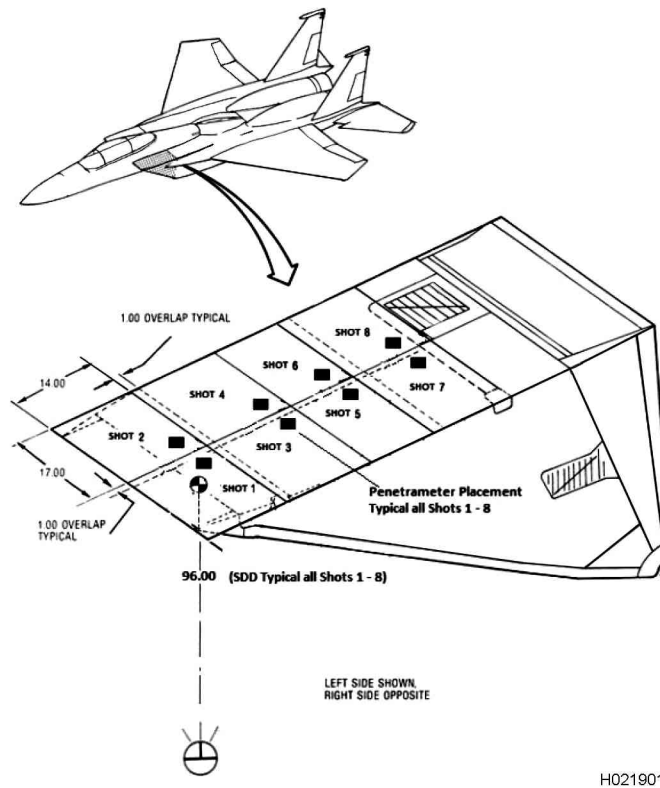
B.8.2 . A cross section of the component showing the position of the crack layer relative to the placement of the detector (IP or film) and X-ray source should be constructed and included with the technique. (Figure B-8).



H0219009

Figure B-8. Structure Cross Section

B.8.3 . Provide IQI and shim selection and placement information. Include in sketches as appropriate. (Figure B-9).



H0219010

Figure B-9. Example Sketch Of IQI (Penetrameter) Placement

B.8.4 . Provide technique information including but not limited to (see Table B-7 for example method chart):

B.8.4.1 Size of detector (IP or film).

B.8.4.2 Lead screen thicknesses (if applicable).

B.8.4.3 IQI size, material, and shim (if applicable).

B.8.4.4 kV, mA, time, and SDD.

Table B-7. Example Method Chart for Multiple Shots

Method Chart									
Shot	Film or Imaging Plate Size (in.)	Screen	Penetrameter		Technique Parameters				Allowable Film Density or PV Range
			Thickness (inch) and Material	Shim Thickness (inch)	kV	mA	Time (seconds)	SDD (inches)	
1	14x17	None	0.25 AL	N/A	50	5	72	48	Film Density 1.5-4.0; PV per TO 33B-1-2 WP 106 01 Table 6
2	14x17	None	0.25 AL	0.15	50	5	72	48	
3 and 4	14x17	5 Mil Front/ 10 Mil Back	1.0 AL	0.50	100	5	72	48	

B.8.5 . (CR only) CR images acquired on the actual component should be considered to be used in the TO to indicate inspection region and provide evaluators with a more-accurate representation of the expected CR image.

B.8.6 . (CR only) Recommended verbiage for technique adjustment and IQI shimming:

B.8.6.1 Measure PV in the thickest (i.e. lightest) and thinnest (i.e. darkest) regions within the area of interest and confirm the PV is within the PV range defined for the system in use per TO 33B-1-2 Table 6 for Crack Detection. If the PV is lower than the Table 6 minimum add exposure time and repeat the exposure. If the PV value is higher than the Table 6 maximum reduce KV and repeat the exposure.

B.8.6.2 Measure the PV on the IQI and confirm that the measurement is the same or less than the PV measurement taken in the area of interest. If the PV is higher in the IQI, add shim material under the IQI and repeat the exposure.

B.8.6.3 Confirm that the outline of the IQI is visible and the 2T hole is detected. If not, lower kV and/or increase time and repeat the exposure.

B.8.7 . (Film only) Recommended verbiage for technique adjustment and IQI shimming:

B.8.7.1 Measure the film density in the thickest (i.e. lightest) and thinnest (i.e. darkest) regions within the area of interest and confirm the film density is between 1.5-4.0. If the film density is <1.5, add exposure time and repeat the exposure. If the film density is >4.0, reduce kV and repeat the exposure.

B.8.7.2 Measure the film density on the IQI and confirm that the measurement is the same or less than the film density in the area of interest. If the film density is higher on the IQI, add shim material under the IQI and repeat the exposure.

B.8.7.3 Confirm that the outline of the IQI is visible and the 2T hole is detected. If not, lower kV and/or increase time and repeat the exposure.

B.8.8 . Other recommended verbiage for technical order procedure:

B.8.8.1 (CR only) The time elapsed between exposures and processing of the IP shall be less than 60 minutes.

B.8.8.2 (CR only) Final evaluation of all images shall be performed using the raw data (no software filters). Adjustment of contrast and brightness (a.k.a. window and level) may be performed manually or using an 'area adjust' or 'region-of-

interest' (ROI) type tools which set the contrast and brightness automatically for a given area of the image as selected by the operator. These tools are permitted for final image evaluation.

B.9 RECORD.

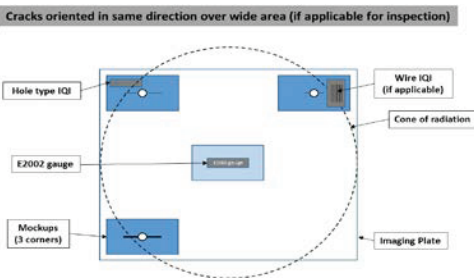
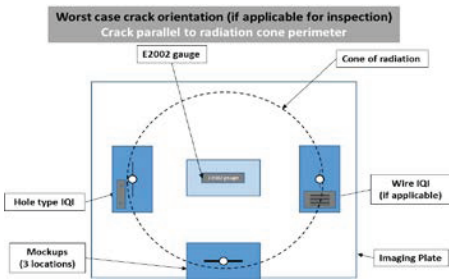
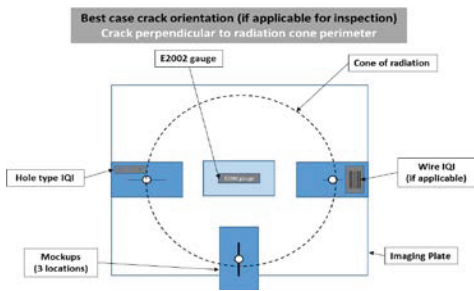
Computed Radiography Technique Development Record (Page 1)										
Inspection Name:					Inspection ID#:					
Date:										
Responsible NDI Level 3:										
Organization:										
Protocol Paragraph #	Protocol Step/Results									
B.4 VERIFY CR SYSTEM PERFORMANCE										
B.4.1	CR System Manufacturer/Model									
	IP Manufacturer/Type									
Process control for crack detection passed? (Per T.O. 33B-1-2 WP 106 01)						(circle one)	Y	N		
B.4.2	Spatial resolution achieved in process control test?				(circle one)	6-7lp/mm		8-10lp/mm		
B.5 ESTABLISH PRELIMINARY TECHNIQUE PARAMETERS										
B.5.1	Structure cross section and stack-up thicknesses of the region of interest				Mockup specimen configurations (from 6.1)					
	Beginning from source side:				Beginning from source side:					
	layer #	crack layer (Y/N)	description	material	thickness (inches)	layer #	crack layer (Y/N)	description	material	thickness (inches)
	Total thickness (inches)				Total thickness (inches)					
Sketch of inspection cross-section										
B.5.2	ODD of crack layer (inches):					ODD				
B.5.3	SDD (inches)									
	B.5.3.1 based on inspection area:									
	B.5.3.2 based on ODD:									
	B.5.3.3 FINAL SDD based on B.5.3.1 THRU B.5.3.3					SDD				
	B.5.3.4 FINAL inspection RADIUS (inches)					Inspection radius				

Figure B-10. Computed Radiography Technique Development Record (Sheet 1 of 3)

Protocol Paragraph #	Protocol Step/Results
----------------------	-----------------------

6	MOCKUP
6.1	Mockup specimen configuration
6.2	IQ(s) used: ASTM E1025 Hole type IQI (material/size) - <i>mandatory</i> ASTM E747 Wire IQI (material group/set ID) - <i>optional</i>
6.3	Mockup Layout (circle one or provide sketch)

Documented on previous page	Y / N
Satisfied by Similarity to Inspection ID#	



Other layout (provide sketch)

H0513002

Figure B-10. Computed Radiography Technique Development Record (Sheet 2)

Protocol Paragraph	Protocol Step/Results	
6 MOCKUP (continued)		
6.4	Mock up technique parameters	Test #
		1 2 3 4 5 6 7 8
	kV	
	mA	
	time (sec)	
	SDD (inches)	
	lead screens front/rear, (mils)	
	Pixel value in area of interest	
	2-2T visible?	
	equivalent wire IQ# (if used)	
6.5	E2002 unsharpness wire pair #	required
		achieved

7 ON-AIRCRAFT VERIFICATION OF TECHNIQUE

7.1 CR System Description used for on-aircraft verification

CR System (manufacturer/model):

Imaging Plate (manufacturer/model):

7.2	On-aircraft technique parameters	Test #				Notes
		1	2	3	4	
	kV					
	mA					
	time (sec)					
	SDD (inches)					
	lead screens front/rear, (mils)					
	Pixel value in area of interest					
	IQI (material/thickness)					
	IQI shim (material/thickness)					
	Pixel value on IQI					
	2-2T visible?					
	Required wire visible? (if used)					

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Figure B-10. Computed Radiography Technique Development Record (Sheet 3)

B.10 SUPPLEMENTAL INFORMATION.

B.10.1 Source-To-Detector Distance.

B.10.1.1 “Required SDD based on cone of radiation and desired area of coverage” ([Figure B-3](#)) was developed using the information published in TO 33B-1-2 paragraph 6.4.2.10.3 and Table 6-12.

- Crack layer thickness ranges listed in [Figure B-3](#) were derived from testing².
- [Figure B-3](#) conservatively assumes worst case orientation of the crack with respect to the cone of radiation. See [Figure B-6](#).
- Worst case crack orientation positions the crack length parallel to the circumference of the cone of radiation, which blurs and reduces the contrast of the crack width as misalignment increases.
- Best case crack orientation positions the crack length perpendicular to the cone of radiation, which only blurs and reduces the contrast of the crack tips, so in many cases the majority of the length of the crack indication maintains optimal contrast and sharpness.

B.10.1.2 “Required SDD for a given ODD” ([Figure B-1](#)) requires the geometric unsharpness (U_g) to be equal or less than 0.006 inch and assumes the focal spot of the X-ray tube is 1.5mm. The U_g threshold of 0.006 inch was established in the USAF CR Crack Detection Study through a sensitivity test which monitored crack detection as U_g varied.

From TO 33B-1-1, para 6.4.2.5:

$$U_g =$$

$$Ft/d,$$

where: F= focal spot,
t = object-to-detector distance, and
d = source-to-object distance.

Using $U_g = 0.006$ inch and solving for SDD:

$$SDD = ODD * [(6.57*F)+1],$$

or

$$\text{For 1.5 mm focal spot, } SDD = 10.9*ODD$$

NOTE

Focal spot measurements are typically measured in accordance with one of two specifications: IEC336 and EN12543. IEC336 is the older of the two specifications and is used to measure the Lorad KVP160 tube focal spot as 1.5mm. EN12543 measures focal spots to be roughly twice the size as measured by IEC336. All USAF test data has been developed using the focal spot as defined by IEC336, so the IEC336 focal spot size shall be used to ensure the appropriate SDD is calculated.

B.10.2 Wire Type IQI Inspection. In some cases, it may be more practical to use a wire IQI instead of a hole type IQI on the aircraft structure. When this is the case, the required wire is established by demonstrating the smallest wire that is visible when the required 2-2T hole is visible on the hole type IQI. For aluminum structures, Materials Group 02 wires are applicable and [Table B-8](#) can be used as guidance. The actual wire must be determined by demonstration.

Table B-8. Guidance for Hole Type IQI

ASTM E1742 (MIL-STD-452) Hole-type/ASTM E747 wire equivalent, 2% sensitivity	
Hole-Type Designation	Wire Identity
0.12	2
0.25	2
0.37	2
0.5	4
0.62	5
0.75	6
0.87	7
1	8
1.2	9
1.5	10

B.10.3 Minimum Exposure Required Based On SDD. “Minimum Exposure required based on SDD” ([Table B-2](#)) is derived based on the minimum exposure parameters required to ensure the signal-to-noise ratio (SNR) is high enough for fatigue crack detection. This is established based on the exposure parameters at a 48 inch SDD used for meeting the %EPS requirement during CR system qualification testing, and adjusting it for other SDD by using the exposure-distance relationship in equation (1). SNR is inversely proportional to % EPS.

(1) Exposure-Distance Relationship

$$E_2 = \frac{E_1 \times D_2^2}{D_1^2}$$

Where:

E_1 = Exposure at D_1

E_2 = Exposure at D_2

D_1 = Source-to-Detector Distance 1, SDD₁

D_2 = Source-to-Detector Distance 2, SDD₂

B.10.4 Image Unsharpness, U_{im} . AFRL testing on fatigue cracks determined that detection capability begins to degrade when geometric unsharpness, U_g , is greater than 0.006 inch. At this maximum U_g , the corresponding U_{im} was measured using an ASTM E2002 gauge to establish the values in [Table B-4](#). Alternately, these U_{im} can be calculated using the formula presented in ASTM E2033:

$$U_{im} = \frac{1}{v} * \sqrt[3]{U_g^3 + (2.0 * SR_b^{detector})^3}$$

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Where:

U_{im} = image unsharpness, measured at the crack plane using the E2002 gauge

U_g = geometric unsharpness

v = geometric magnification

SR_b^{detector} = basic spatial resolution of the CR system measured at the imaging plate using the TO 33B-1-2 WP 106 01 procedure for spatial resolution (i.e. line pair per mm using lead foil gauges)

NOTE

The ASTM E2002 (U_{im}) evaluation ensures the SDD selected will apply in cases where the CR system used for technique development is different than other qualified CR systems that may be used to perform the inspection in the future. (For example: If the CR system used for technique development can achieve 10 lp/mm spatial resolution using the USAF CRPCS, where $U_g=0$, it must be able to resolve the #10 wire of the E2002 unsharpness gauge placed on the part being inspected. This ensures that a CR system with the minimum 6 lp/mm capability will be able to resolve the minimum requirement of the #9 wire of the E2002 gauge).

B.11 REFERENCES.

B.11.1 . Computed Radiography Qualification (Performance) Test Procedure for Crack Detection Systems, UDRI TR-2011-73 (2011).

B.11.2 . TO 33B-1-1, Nondestructive Inspection Methods, Basic Theory.

B.11.3 . TO 33B-1-2, Nondestructive Inspection General Procedures And Process Controls.

APPENDIX C

NDI MISS ROOT CAUSE ANALYSIS GUIDELINES

C.1 INTRODUCTION.

This appendix provides guidance for investigating incidents in which detectable cracks in safety-of-flight aircraft structure have been missed by approved nondestructive inspection (NDI) techniques. This guidance can be used as a stand-alone process or in conjunction with the 8-Step Systematic Problem Solving Model process defined AFMCI 90-104, Implementing AFSO21 Initiatives as appropriate. In summary, the 8-Step AFMCI 90-104 process includes:

- Step #1: (Observe) Clarify the problem.
- Step #2: (Observe) Break down problem; identify performance gaps.
- Step #3: (Orient) Set improvement target.
- Step #4: (Orient) Determine root causes.
- Step #5: (Decide) Develop countermeasures.
- Step #6: (Act) See countermeasures through.
- Step #7: (Act) Confirm results and process.
- Step #8: (Act) Standardize successful processes.

This document focuses on processes for determining when a root cause analysis is necessary for NDI miss events and provides specific guidance on determining the root causes (Step 4). A successful root cause analysis will identify the, controllable, causal factors that can be corrected to eliminate the recurrence of similar incidents in the future. This appendix also highlights methods that may be used in conducting root cause analysis. Though there are numerous methods that can be used when conducting a root cause analysis, this guide focuses on the application of the following two methods:

- Sequential Events and Conditions Analysis (Section C.11)
- Cause and Effect Analysis (Section C.12)

C.2 SUMMARY.

The objective of investigating and reporting NDI misses is to enable the identification of corrective actions required to prevent recurrence and thereby protect the safety-of-flight of Air Force weapons systems as well as to ensure the safety of the pilots, passengers, maintainers and the civilian community. The investigation process is critical to fully understanding the events and conditions leading to the miss and what corrective actions are necessary to prevent recurrence. During a root cause analysis, numerous causal factors (i.e. “causes”) may be identified. To reduce the probability of recurrence, each causal factor should be addressed by a corrective action or series of corrective actions that are within the control of the organization. Root cause analysis can be performed using a number of different methods. This guide recommends and summarizes methods which are applicable to analyzing inspection related incidents in the U.S. Air Force; however, the basic approach and techniques described can apply to the investigation of any type of failure of a system, process, or component. The level of effort expended on such analyses should be commensurate with the significance or severity of the incident. If a NDI miss is investigation is conducted as part of a formal Safety Investigation, the information gathered during the investigation must be protected as privileged and will be controlled as part of the Safety Investigation Board (SIB) findings.

C.3 INVESTIGATION PHASES.

When investigating the root cause of an NDI miss the following methodology should be followed:

- a. Identify the incident as a Type (I, II, or III), using the guidance of [Table C-1](#), based on the circumstances surrounding the incident.
- b. Form the investigation team (Refer to Section C.5) based on the resources and expertise required to complete the investigation.

- c. Conduct the five-phased root cause investigation (see details below).

NOTE

Management involvement and adequate allocation of resources are essential to successfully execute the investigation.

C.3.1 Phase I: Collecting. This phase collects all information relevant to the incident for subsequent analysis. It is important to begin the data collection phase immediately following an incident. Information includes: a) conditions before, during, and after the incident, b) personnel involved, actions and conditions surrounding the incident, c) environmental factors, d) human factors, e) historical data and f) other information having relevance to the incident. Guidance for conducting Phase I can be found in Section C.6.

C.3.2 Phase II: Analyzing. This phase consists of the causal factor analysis. The root cause analysis methods defined in Sections 11 and 12 are recommended and include the following steps. Refer to Section C.7 for guidance.

- a. Identify the problem.
- b. Determine the significance of the problem.
- c. Identify the events, conditions and actions immediately preceding and surrounding the problem.
- d. Identify all causal factors. Identify the primary cause or causes (i.e. root cause(s)) that directly contributed to the incident.

C.3.3 Correcting. Identify corrective actions for each causal factor to reduce the probability that an incident will recur. Guidance for conducting Phase III can be found in Section C.8.

C.3.4 Informing. Communicate the results of the investigation to management and personnel involved. A summary report should include findings, the results of the root cause analysis, and all corrective actions recommended and/or implemented. The results should be distributed to other organizations involved in the process or performing similar operations. Guidance for conducting Phase IV can be found in Section C.9.

C.3.5 Verifying. Assess the effectiveness of the corrective actions. This step is key to preventing reoccurrence. Guidance for conducting Phase V can be found in Section C.10.

C.4 DEFINITIONS.

C.4.1 Causal Factors (Cause). Conditions or events that contribute to a failure or incident. For example: a) poor signal-to-noise in an inspection, b) failures to follow defined procedures, c) failure to validate procedures, weaknesses or deficiencies in management or administration.

C.4.2 Causal Factor Chain. A sequence of conditions, actions, or decisions that create a condition that contributes to, or results in, an event. Each event may create new conditions that, in turn, contribute to or result in another incident. The sequence of events ultimately leads to the incident under investigation.

C.4.3 Condition. Any as-found state, whether or not resulting from an event, that may have adverse safety, operational, readiness, or mission capability implications. Examples include, an error in assumed detectable flaw size, an anomaly associated with or resulting from system design or performance, poorly written procedures or management or process shortfalls.

C.4.4 Contributing Cause. A cause that contributed to an incident but, by itself, would not have caused the incident. For example, in the case of the failure of an inspection to detect a large crack in safety-of-flight structure, a contributing cause could be an inspector's fatigue reducing the inspectors focus to the task.

C.4.5 **Crack Lengths.** Various crack lengths are of interest when performing a root cause analysis for cracks that are undetected by nondestructive inspection techniques. Many of these crack lengths are graphically defined in [Figure C-1](#). These crack lengths include:

- a_o , a_i , or a_{init} -The length of the starting, inherent, or initial crack existing within a structure at the time of manufacture (refer to MIL-STD-1530).
- a_{NDI} -The length of the largest crack that an NDI method can miss based upon probability of detection (POD) studies and usually corresponding to a “90/95” crack length (i.e. a crack length that can be found 90% of the time with 95% confidence). Also known as the “minimum detectable crack size.”
- a_{miss} -The length of a crack missed (undetected) by a nondestructive inspection.
- $a_{critical}$, a_{crit} , or a_{cr} - The critical length of a crack above which the crack will grow catastrophically to failure upon the application of the next design limit load cycle.
- $a_{cr-miss}$ -The length of a crack that, if missed (undetected) by a nondestructive inspection, will grow catastrophically to failure (i.e. to a_{crit}) before the next inspection.

C.4.6 **Facility.** Any organization or work activity that performs a function. Examples include Air Logistics Centers (ALC’s), field-level inspection laboratories, flight-lines, maintenance facilities, contractors conducting inspections and any location or organization where inspection or maintenance actions occur.

C.4.7 **Incident.** The failure of a system, process, or component that has the potential to seriously impact safety and/or mission capability. An incident usually results through the interaction of a number of causes. For the purposes of this guide, incidents are failures of nondestructive inspection processes to detect cracks in safety- of-flight aircraft structures. Such incidents may be classified into three general categories described below in [Figure C-1](#) and in [Table C-1](#).

C.4.8 **Type I Incident.** A Type I incident is any incident that resulted in or could result in a Class A mishap or that poses a high risk to flight safety or mission capability. The consequences of a Type I incident are a loss of life or aircraft or effects which would result in a mishap. If the incident contributes to a mishap these investigations are often conducted as part of a Safety Investigation Board and the findings are protected as privileged.

C.4.8.1 An undetected crack incident is classified as Type I if a crack with length a_{miss} is undetected and if $a_{miss} \geq a_{cr-miss}$. In this case, the undetected crack with length a_{miss} can grow to a length of $a_{critical}$ in a period that is less than one inspection interval (i.e. it can grow to length of $a_{critical}$ before the next inspection). Type I incidents require documentation of a formal root cause analysis to identify the causal factors and program deficiencies.

C.4.9 **Type II Incident.** A Type II incident is any incident that poses a moderate risk to flight safety and/or mission capability. The consequences of a Type II incident are major readiness or economic impacts.

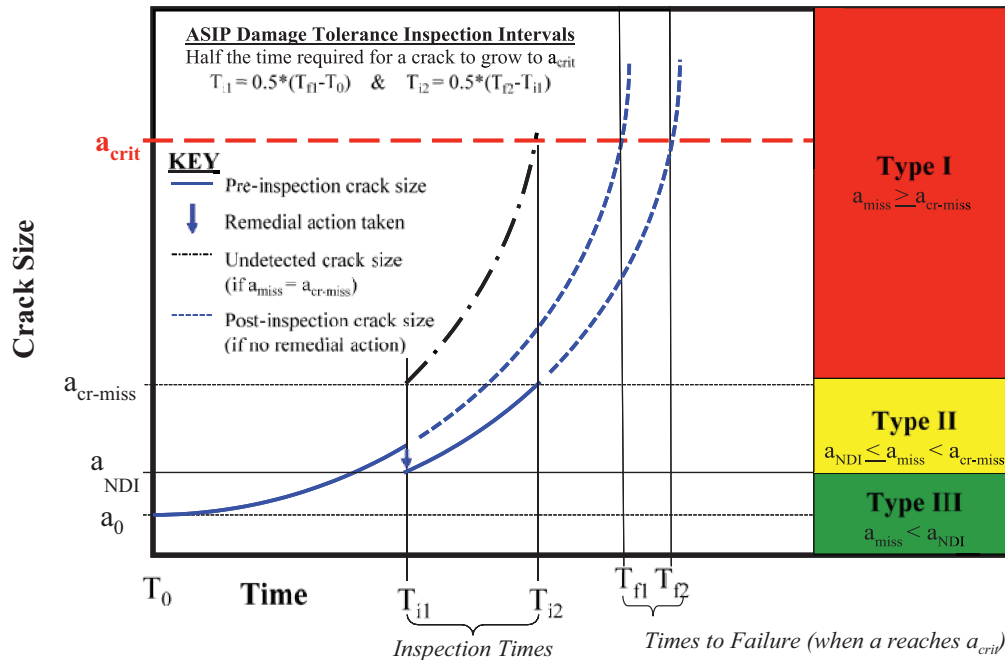
C.4.9.1 An undetected crack incident is classified as Type II if a crack with length a_{miss} is undetected and if $a_{NDI} \leq a_{miss} < a_{cr-miss}$. In this case, the undetected crack with length a_{miss} cannot grow to a length of $a_{critical}$ in a period that is less than one inspection interval (i.e. it cannot grow to length of $a_{critical}$ before the next inspection). Type I incidents also require documentation of a formal root cause analysis to identify the causal factors and program deficiencies.

C.4.10 **Type III Incident.** A Type III incident is any incident that poses a low risk to flight safety or mission capability but that may be an indication of wider program issues that require attention. Type III incidents may not have any significant consequences beyond the need to apply standard repairs (find and fix).

C.4.10.1 An undetected crack incident is classified as Type III if a crack with length a_{miss} is undetected and if $a_{miss} < a_{NDI}$. In this case, the undetected crack with length a_{miss} cannot grow to a length of $a_{critical}$ in a period that is less than two inspection intervals (i.e. it cannot grow to length of $a_{critical}$ before two inspections have been performed). It is expected that the next inspection interval will detect these cracks before they grow to length $a_{cr-miss}$. Type III incidents do not require a formal root cause analysis; however, it is recommended that sufficient information be gathered to enable the formulation of conclusions that could identify systemic issues particularly if repeated occurrences exist.

Table C-1. Incident Types, Potential Consequences For Undetected Cracking Incidents In Safety-of-Flight Structures

Type I	Type II	Type III
Consequence: Loss of or Significant Damage to Aircraft Class A Mishap	Consequence: Major Readiness or Economic Impact	Consequence: Standard Repair Required
Criteria: $a_{miss} > a_{cr-miss}$ The undetected crack can grow to $a_{critical}$ in a period that is less than one inspection interval (i.e. it can grow to $a_{critical}$ before the next inspection)	Criteria: $a_{NDI} \leq a_{miss} < a_{cr-miss}$ The undetected crack cannot grow to $a_{critical}$ in a period that is less than one inspection interval (i.e. it cannot grow to $a_{critical}$ before the next inspection)	Criteria: $a_{miss} < a_{NDI}$ The undetected cannot grow to $a_{critical}$ in a period that is less than two inspection intervals (i.e. it cannot grow to $a_{critical}$ before two inspections have been performed)
Requires formal Root Cause Analysis and Reporting	Requires formal Root Cause Analysis and Reporting	Does not require formal Root-Cause Analysis



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Figure C-1. Establishing The Type Of An Undetected Crack Incident

C.4.11 **Root Cause.** The cause or causes that, if corrected, would prevent recurrence of the incident under investigation and similar incidents. It is the most fundamental cause that can logically be identified and corrected.

C.4.12 Root Cause Analysis Report. A written evaluation that documents the causal factors in detail and enables the reader to assess their significance and includes recommendations to correct the condition to prevent recurrence.

C.4.13 Reportable Incident. An event or condition that meets the factors of a Type I or Type II incident.

C.5 THE INVESTIGATION TEAM.

It is recommended an investigation team encompass the minimum number of subject matter experts required to effectively and efficiently complete the investigation. Team members must be completely objective. For situations where the incident occurred within the depot, external expertise should be utilized to ensure investigation impartiality. For investigation of Type I and II incidents on U.S Air Force safety-of-flight aircraft structures (airframe or engine), the following team composition is recommended.

- Airframe or Propulsion Program Manager-Lead
- Depot NDI Program Manager-Co-Lead Depot NDI
- Representative Quality Representative
- Union Representative Airframe NDI Technician
- Additional Subject Matter Experts:
 - Human Factors Expert
 - Root-Cause Analysis Facilitator
 - Additional external structural and NDI experts as required to ensure investigation impartiality
 - OEM Engineering

C.6 PHASE I-COLLECTING.

The Collecting phase must begin immediately following the identification of an NDI miss to minimize data loss and ensure involved personnel have the best recollection of the events and conditions surrounding the incident. The primary objective of the Collecting phase is to document and organize all available information related to the NDI miss. The information that should be collected consists of conditions before, during, and after the incident; personnel involved; actions taken; environmental factors; human factors and any other relevant information. Data to be collected should include the following:

- Activities, conditions, events related to the inspection miss.
- Problems with procedures, equipment, software, etc.:
 - Inspection procedure adequacy.
 - Equipment problems, maintenance records, process control records.
 - Proper validation and verification of procedures, equipment and standards.
 - Correct and complete identification of the inspection area.
 - Use of unapproved equipment, probes or standards.
 - Unquantified detection capability.
 - Software bugs or incorrect software version.
- Personnel or Management issues:
 - Inspector competency.
 - Inspection/inspector scheduling.
 - Shift-change hand-off.
 - Morale concerns.
 - Insufficient training or refresher training.
 - Recent personnel or management changes.
- Physical environment or circumstances such as facility temperature, humidity, lighting, noise levels, etc.
- Human factors issues such as:
 - Inspector fatigue level.
 - Attitude.
 - Inspector health.

- Distractions.
- Inspection task handoff errors.
- Inspection location identification errors.
- Scan plan errors.
- Visual acuity or visual fatigue concerns. etc.
- Conduct fact finding not fault finding interviews and collect statements from involved personnel. This point is critical and cannot be over emphasized, the investigation must be conducted on non-attribution basis, In most NDI miss cases the incident is the result of a cascade of multiple events, conditions and decisions that converge to the point of inspection.
- Prepare questions ahead of time and conduct interviews in person whenever possible. Interview individuals directly involved with the activities surrounding the miss as well as personnel who have performed the inspection in the past. Fully document the results of the interviews in a summary report. Maintain the anonymity of the personnel involved whenever possible.
- Conduct a "walk-through" of all events leading up to and following an incident. Most importantly, a step-by-step walk-through of the entire inspection process must be performed. Be sure to have all relevant documentation including procedures, travelers, etc. available as a reference during the walkthrough. It is highly recommended that the walk through be conducted with the personnel directly involved. The primary objectives of this activity are to:
 - Determine how the inspection was actually performed.
 - Identify issues related to human factors, procedures, instructions, training, aircraft access or surface preparation, etc.It is also recommended that the walkthrough also be performed with multiple individuals who may perform the same inspection to identify common errors or discrepant conditions. The task should be observed in the same environment and conditions as it is normally performed.

All relevant observations and potential problems should be summarized. A Sequential Events and Conditions chart should be generated to help summarize the observations. See Section 11.0.
- Every effort should be made to preserve physical evidence such as failed components, equipment, and inspection materials. If an inspection involves penetrant or magnetic particle inspection, collect a sample of the inspection materials for testing.
- Records - Review relevant documents in support of the root cause analysis. Record appropriate dates and times associated with the incident on the documents reviewed. Examples of documents include:
 - Travelers.
 - Work orders.
 - Inspection schedules.
 - Training records.
 - Correspondence.
 - Inspection records and evidence of signoff.
 - Inspection results (radiographs, photos, screen shots, etc.)
 - Equipment or facility maintenance records.
 - Process control records.
 - Meeting minutes.
 - Procedures and instructions.
 - Work cards.
 - Vendor Manuals.
 - Drawings and specifications.
 - Equipment history records (repair, calibration, etc.)
 - Related quality control documents.
- Related Information: Additional information that an evaluator should consider when analyzing the causes include:
 - Failure analysis reports.
 - The physical layout of inspection area, structure/component inspected, work area, including layout sketches and/or photographs.
 - Photographs of inspection access, physical position of inspector, instrument/display location, and probe placement during inspection.

- Historical information of previous inspection results and similar incidents if they have occurred at the same facility or facilities with similar inspection requirements.
- Instrument, reference standards or probe/transducer records including performance and reference standard certifications, calibration records or correspondence that addressed system performance issues.
- Unique human factors concerns surrounding the incident.

C.7 PHASE II-ANALYZING.

C.7.1 Root Cause Analysis Methods. Numerous methods exist for conducting root cause analysis. However, for the purposes of this guide the following methods are recommended.

- Sequential Events and Conditions Analysis
- Cause and Effect Analysis (Fishbone Diagram)

NOTE

The extent to which these methods are used and the level of analytical effort spent on root cause analysis should be commensurate with the significance of the incident. A high-level of effort should be spent on Type I incidents related to safety-of-flight; an intermediate level should be spent on serious incidents (Type II); and a relatively low-level effort should be adequate for most minor incidents with no safety impact (Type III). In any case, the depth of analysis should be adequate to explain why the incident happened, determine how to prevent recurrence, and assign responsibility for corrective actions.

C.7.2 Sequential Events and Conditions Analysis. This method summarizes the sequential events and conditions surrounding an NDI miss in a sequential flowchart. The sequence of actions or activities leading up to and immediately following the incident is a “chain of events”. Events are significant occurrences or something that happens during the course of events. Conditions are things that shape the event outcome; such as physical/environmental conditions (e.g. surface condition of the component being inspected, inspection access or temperature of the working environment). Other factors such as inspector attitudes and organizational culture are also important to document if possible. **Human factors influences must be thoroughly evaluated and documented as they are often contributing factors to inspection misses.**

C.7.3 Cause and Effect Analysis (Fishbone Diagram). Cause and Effect Analysis develops, sorts and validates hypotheses about possible causes of an incident by exploring all possible causes and effects. The primary tool for generating this analysis is a Cause and Effect Diagram (a.k.a Fishbone Diagram). Links are established between events and their causes and provides a means of validating and isolating causal factors.

C.7.3.1 Step 1. Determine the Causal Factor Chain (the Sequence of Events and Conditions).

- a. Document the sequence of events and/or actions that led up to the inspection miss as well as their surrounding conditions. Document the sequence of events using a Sequential Events and Conditions Chart (Section C.11). The chart is updated as investigation proceeds and evidence is gathered.
- b. Develop the Sequential Events and Conditions chart by working both backwards from the inspection miss and forward to the failure discovery, identifying the events/actions and their associated conditions along the chain of events.
- c. Continue to work backwards and identify successively earlier events/actions and conditions and their relationship to the incident.

C.7.3.2 Step 2. Analyze the Causal Factors. Generate a Causal and Effect Diagram (a.k.a Fishbone Diagram) (Section C.12). Gather data and evidence to validate or eliminate possible causal factors. Update the diagram as supporting data and evidence is obtained.

C.7.3.3 Summarizing Findings, List Causal Factors.

- a. Summarize and categorize the causal factors in one of 6 major categories or sources:
 - Procedures
 - Equipment
 - Personnel
 - Design/Engineering
 - Management
 - External Factors
- b. Prioritize the causal factors in terms of their contribution to the incident being investigated.

C.8 PHASE III-CORRECTING.

In Phase III effective corrective actions are identified, validated, the required resources required to implement are identified and the corrective actions are implemented. Use a systems approach when determining appropriate corrective actions. Corrective actions should be evaluated to ensure they not only prevent reoccurrence but to also ensure the corrective actions have no unintended consequences. Identify a corrective action for each causal factor and be sure the corrective action is viable, within the ability of the organization to correct, and verifiable.

C.9 PHASE IV-INFORMING.

Effective prevention requires the distribution of summary reports and lessons learned to all personnel and organizations who might benefit. Findings must be shared with personnel directly associated with the incident, their direct reporting chain as well as facilities and organizations who perform similar work. For Air Force investigations of inspection misses, it is recommended that, at a minimum, the following personnel and organizations be informed of the investigation findings and recommended corrective actions:

- Affected Inspection Facility Personnel
- Affected Inspection Facility Supervisor and Commander
- All Facilities Performing Similar Inspections
- System Chief Engineer
- Weapon SystemManager
- Air Force NDI Office-AFLCMC/EZPT
- Major Command NDI Functional (MAJCOM/A4)
- Air Force Safety Center
- HQ AFMC/A4

C.10 PHASE V-VERIFYING.

Corrective actions should be tracked to ensure that they have been properly implemented and are effective. The recurrence of the same or similar incidents must be identified and analyzed. If an incident recurs, the original incident should be re-

evaluated to determine why the original corrective actions were ineffective or not implemented and what additional measures are required to prevent recurrence.

C.11 SEQUENTIAL EVENTS AND CONDITIONS ANALYSIS.

A Sequential Events and Conditions chart illustrates the chronology of events and illustrates the relationships and interactions between the involved organizations and individuals and provides links to incident factors such as organizational and management controls. Guidelines for Practical Application:

- a. Develop a “working chart” as soon as the investigation begins.
- b. Update and expand the charts as observations and evidence is gathered.
- c. Use an easily updated format.
- d. Select the appropriate level detail in the working chart to explore all possible events and conditions.
- e. Generate an executive summary chart and incident narrative. The working chart will contain considerably more detail generally required to guide the investigation. Significantly less detail is required for the summary report.

C.11.1 Conventions for Events and Conditions Analysis Charting.

- a. Enclose events in rectangles, and conditions in ovals. Factual events and conditions are illustrated using rectangles or ovals with solid lines.



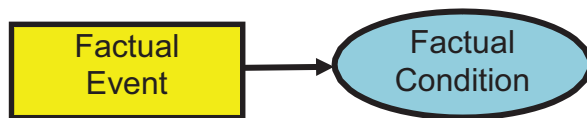
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- b. Presumed events or conditions that cannot be supported by direct evidence are illustrated using ovals or rectangles with dashed lines.



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- c. Connected events with arrows.



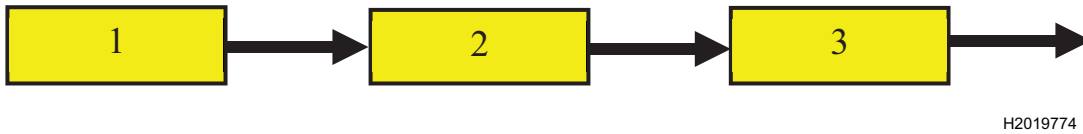
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- d. Connect conditions with conditions and conditions with events with dashed arrows.



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- e. The primary sequence of events are illustrated using straight rows with events joined by bold arrows.



- f. Chronologically arrange events from left to right.
- g. Events must be arranged in a logical progression from the beginning to the end of the event chain.
- h. Secondary event sequences, conditions/contributing factors, should be depicted on horizontal lines at different levels above or below the primary sequence.

C.11.1.1 Events.

- a. Each event should describe an activity or incident, e.g. “Aircraft was grounded due to large crack in wing causing a fuel leak”. An event is not a condition, state, conclusion, or result.
- b. Each event should be described by a short sentence with a subject and active verb; i.e., “technician performed visual inspection of landing gear trunnion”, not “technician wiped down the landing gear trunnion with solvent and then performed visual inspection”.
- c. Each event should be precisely described; i.e., “the technician adjusted the inspection frequency to 20kHz, not “the technician selected the inspection frequency”.
- d. Each event should describe a single, discrete incident; i.e., “flap-track liberated from airframe and FODed engine”, not “flap-track liberated from aircraft and FODed engine and the aircraft lost altitude and crashed”.
- e. Each event should be quantified when possible; i.e., “plane rapidly descended to 350 feet”, not “plane lost altitude.”
- f. Each event should be derived directly from the event (or events in the case of a branched chain) and conditions preceding it; i.e., “inspector identified inspection location by ‘feel’ using right hand” is preceded by “inspector crawled into fuel cell to gain access” which is preceded by “the crew chief removed fuel cell access panel IAW TO”. Identify each event in a logical sequence one event preceding the next.

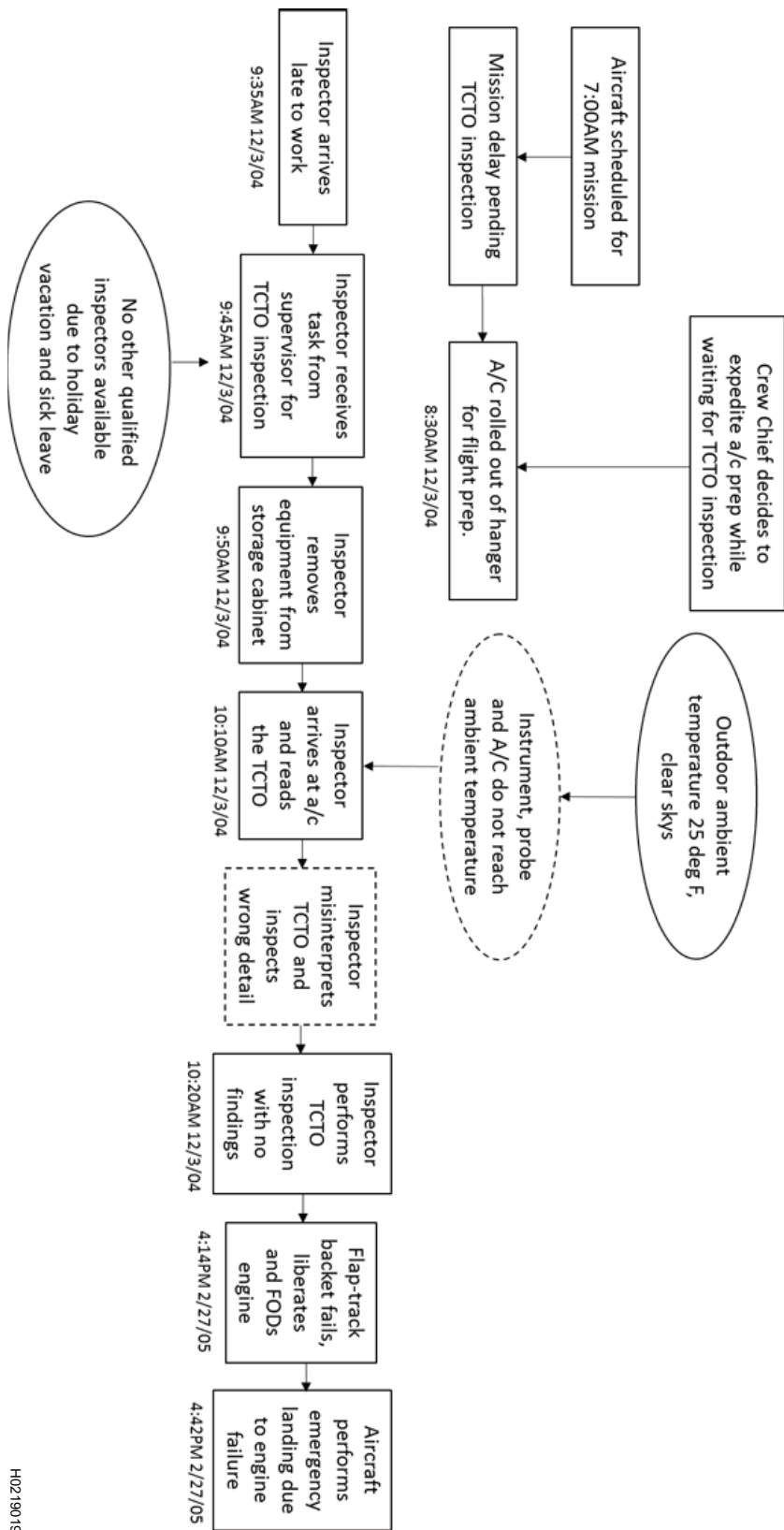
C.11.1.2 Conditions. Conditions describe states or circumstances, not actions. Conditions should be precisely described, quantified when possible, posted with time and date when possible. Conditions should be derived directly from the conditions immediately preceding them.

C.11.2 Events And Conditions Chart Example.

C.11.2.1 Incident Description. A 30 day time compliance technical order (TCTO) was released requiring eddy current inspection of the wing flap track on a twin engine US Air Force aircraft. The TCTO tech data was successfully validated by depot NDI and structural engineering prior to TCTO release. The TCTO was scheduled to be accomplished on 21 December 2004, on A/C 90-678 prior to a scheduled 7:00 AM training mission. The aircraft was grounded pending successful performance of the TCTO. The inspector assigned to the inspection task was late arriving to work. No other inspection personnel were available at the time due holiday vacations. To expedite flight preparations, the crew chief rolled the aircraft out of the hangar at 8:00 AM to perform an engine check. At 9:35 AM the inspector arrives at work and is assigned the task by his supervisor. At 10:00 AM the inspector arrives at the aircraft and performs the inspection. The outdoor ambient temperature was 25°F with light winds at the time of the inspection. The indoor ambient condition where the inspection equipment was stored was 65°F. On 27 February 2005, A/C 90- 678, experienced an in-flight failure of the left engine, declared an in-flight emergency and landed safely at a local municipal airport. A subsequent failure analysis revealed that the left-wing flap-track failed, resulting in the in-flight liberation of a mounting bracket. The bracket was ingested by the engine, resulting in FOD damage and engine failure. Laboratory analysis indicted the flap track failed due to fatigue. Analysis also indicates that the crack with surface length between a_{NDI} and $a_{critical}$ was present during the previous inspection. The resulting in-

investigation revealed that the inspector did not properly interpret the TCTO requirements and did not accurately locate the required inspection detail. This was verified through an interview with the inspection and an inspection walkthrough. Furthermore, ambiguities in the technical data drawings were identified that could potentially lead to incorrect identification of the inspection locations. At the time of the inspection the inspector had concerns with the guidance but no-one was available to provide assistance in interpretation. The following causal factors were identified; a) failure of the inspector to properly interpret the technical data and b) the inspector was rushed to complete the inspection in a timely manner to enable commencement of flight operations, c) inadequate guidance in the technical data structural drawings, d) failure of management to ensure sufficient personnel resources to address mission needs.

C.11.2.2 Discussion. [Figure C-2](#) is the Events and Conditions chart of this incident. Note that the events are in chronological order, that each follows logically from the one preceding and that the dates are indicated where known. Events are enclosed in rectangles and the conditions in ovals. Primary events are connected by bold solid lines, other events by solid lines, and conditions by dashed lines. Presumptive information (i.e., the inference is clear but the evidence is lacking) is shown in ovals and rectangles drawn in dashed lines.



H0219019

Figure C-2. Sequential Events & Conditions Chart Example

C.12 CAUSE AND EFFECTS ANALYSIS.

Cause and Effect Analysis (a.k.a Fishbone Diagram) is a tool that generates and sorts hypotheses about possible causes by listing all possible causes and effects. A Cause and Effect Diagram, if performed effectively, quickly sorts and illustrates possible causes of the incident and organizes data supporting the conclusions of the analysis. This diagram should incorporate the findings from the Sequential Events and Conditions analysis.

C.12.1 Developing a Cause-and-Effect Diagram. Use the following major cause categories or branches to generate the diagram:

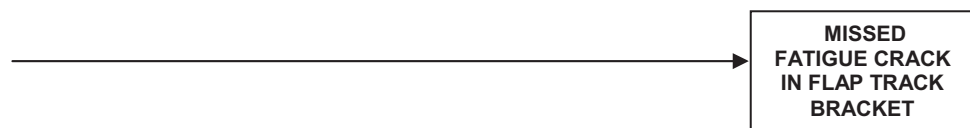
- Equipment/Material Deficiency
- Procedure Deficiency
- Personnel Deficiency (includes training)
- Design/Engineering Deficiency (includes incorrect assumptions)
- Management/Organizational Deficiency
- External Factors

C.12.1.1 These categories have been selected with the intent to address typical classes of problems that could arise while conducting inspection and maintenance operations. The first three categories are necessary to perform any inspection task (equipment, procedures and personnel). Personnel also includes training. Design determines the quality and effectiveness of equipment or design assumption used to ensure system safety. Management is also a necessary element as it provides the priorities and resources to support requirements. External factor beyond operational control serves as a seventh cause category. The steps for constructing and analyzing a Cause-and-Effect Diagram are as follows:

- Identify and clearly define the EFFECT to be analyzed.
 - Effects are stated as a fault conditions or the result or outcome of a fault condition.
 - Develop a simple and accurate definition of the effect to ensure that it is clearly understood.
- Draw the EFFECT box.
 - Draw a horizontal arrow pointing to the right to create the main spline.
 - To the right of the arrow, write a brief description of the effect.
 - Draw a box around the description of the effect.

NOTE

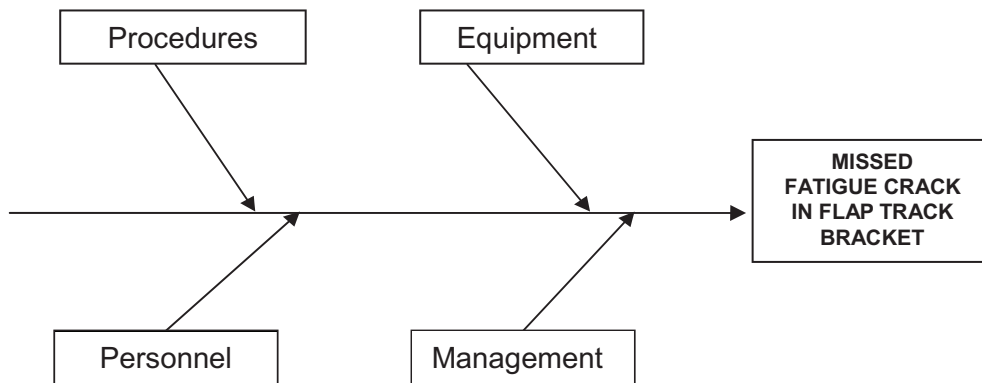
The following example diagrams the causes relating to a fatigue crack missed during an inspection of an aircraft flap track. The EFFECT is Missed Fatigue Crack in Flap Track Bracket (See [Figure C-3](#)).



H0219020

Figure C-3. Main Spline Drawn To The Effect

- c. Identify the main possible CAUSES contributing to the effect. It is recommended the main categories previously identified be used. These are the labels for the major branches of your diagram and become categories under which to list the main causes related to those categories.
- (1) Start by including all cause categories at the beginning of the investigation and eliminate those cause categories that are not supported by evidence.
 - (2) Illustrate the categories to the left of the effect box, some above the arrow and some below it. Once specific categories are eliminated from consideration they no longer need to be represented.
 - (3) Draw a box around each category label and use a diagonal line or arrow to form a branch connecting the box to the main spline. See [Figure C-4](#) for an example including four cause categories.



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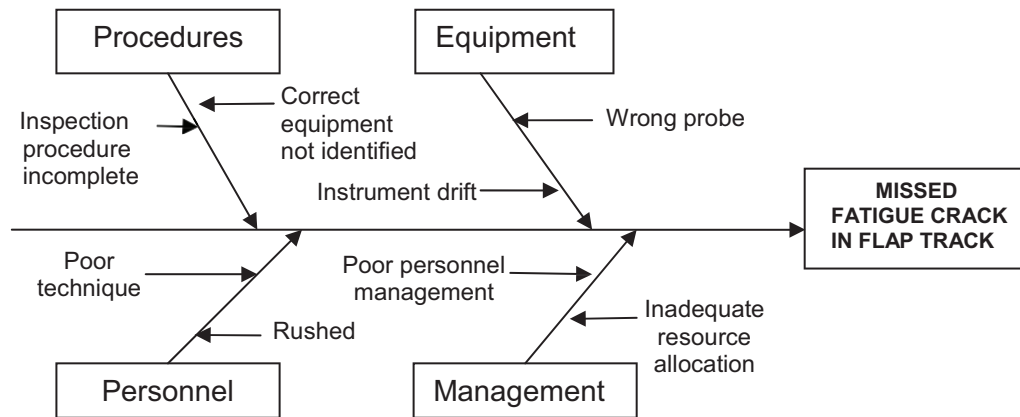
Figure C-4. Main Cause Categories Connected By A Spline To The Effect

- d. For each major branch, identify CAUSES that may have influenced or contributed to the EFFECT.
- (1) Identify as many causes as possible and attach them as sub-branches of the major branches.

NOTE

EXAMPLE: The possible CAUSES for the Missed Fatigue Crack in Flap Track Bracket are listed under the appropriate categories in [Figure C-5](#).

- (2) Fill in detail for each cause. If a minor cause applies to more than one major cause, list it under both.



H0219022

Figure C-5. Cause And Effects (Fishbone) Diagram-First Level Causes

- e. Identify increasingly detailed levels of causes and continue organizing them under related causes or categories. Use a series of why questions to help fill in the detailed levels.
 Example:

PROCEDURES

Q: Why were the PROCEDURES INCOMPLETE?

A: Poor definition of inspection zone.

Q: Why was the inspection zone poorly defined?

A: Procedure not properly verified.

EQUIPMENT

Q: Why was the WRONG PROBE used?

A: Instructions ignored.

Q: Why were the instructions ignored?

A: Inspector inexperience.

A: Inspector unprepared/pressured.

A: Correct probe failed and not available.

Q: Why was a replacement probe not available?

A: No \$ for replacement.

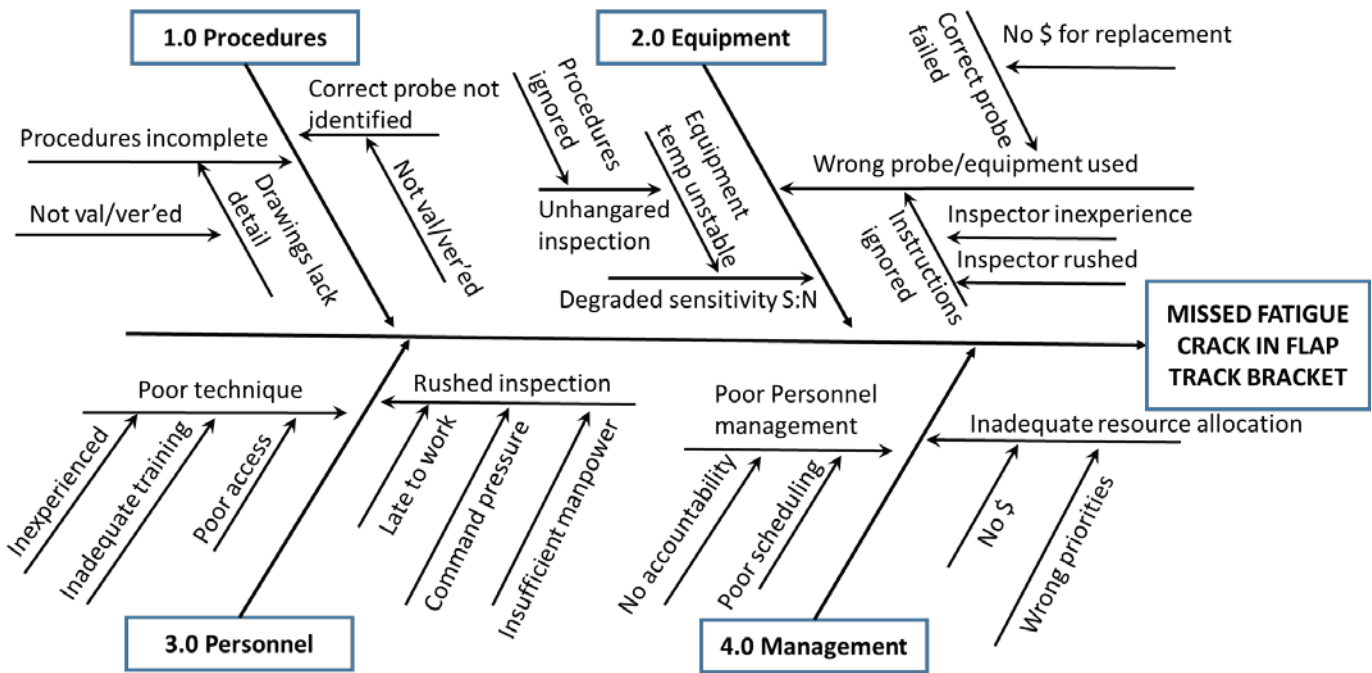
PERSONNEL

Q: Why was the inspector rushed?

A: Late to work.

A: Command pressure - Wing Commander angry due to mission delay.

- [Figure C-6](#) shows an example diagram where all the possible contributing causes have been identified. As in this example, there may be many levels of causes contributing to the effect.
- TIP: You may need to break the diagram into smaller diagrams if one branch has too many sub-branches.



H0219023

Figure C-6. Main Spline Drawn To The Effect

- f. Assign a numeric code for each of the causes and minor causes. One approach is shown in the following example:
 EXAMPLE: See Figure Note: Cause level expanded further

- 3.0 EQUIPMENT
 - 3.1 Instrument drift
 - 3.1.1 Equipment temp unstable
 - 3.1.1.1 Unhanged Inspection
 - 3.1.1.1.1 Inadequate procedures
 - 3.1.1.1.2 Instructions ignored
 - 3.2 Wrong Probe Used
 - 3.2.1 Correct probe failed. No \$ for replacement
 - 3.2.2 Instructions ignored
 - 3.2.2.1 Inadequate experience/training
 - 3.2.2.2 Inspector rushed

- On a spreadsheet, for each cause, list the possible major causes and each minor cause and supporting or refuting evidence. An example is given in [Figure C-7](#).
- All possible minor causes must be validated, with supporting evidence, as either valid or invalid. If sufficient evidence indicates the minor cause(s) are invalid then they should be eliminated as possible contributors. It is recommended the Cause and Effect Diagram and supporting spreadsheet be color coded to clearly illustrate the distinction between valid, invalid causes and possible causes that require further analysis.

RED – PROVEN INVALID

GREEN – PROVEN VALID

BLUE – FURTHER ANALYSIS REQUIRED

2.0 Equipment	Supporting or Refuting Evidence
2.1 Degraded inspection sensitivity	<ul style="list-style-type: none"> • During interview inspector reported unexplained instrument drift
2.1.1 Equipment temp not stable	<ul style="list-style-type: none"> • Recreation of inspection ambient conditions did not result in level of drift reported by inspector - further test required
2.1.1.1 Unhanged Inspection	<ul style="list-style-type: none"> • Interview with inspector indicated inspection was conducted on flightline. Outdoor temperature at the time was approximately 25° F. • Inspector indicated he did not follow T.O. Chapter 1 requirements for equipment temperature stabilization.
2.2 Wrong probe used	<ul style="list-style-type: none"> • Interview with inspector indicated correct shielded probe used. Shielded probe required when inspection around ferromagnetic bushings.
2.2.1 Correct probe failed	<ul style="list-style-type: none"> • Correct shielded probe found in NDI shop.
2.2.1.1 No \$ for replacement	<ul style="list-style-type: none"> • Sufficient funds available at the time.
2.2.2 Instructions ignored	<ul style="list-style-type: none"> • All evidence indicates inspector selected correct probe
2.2.2.1 Inspector inexperience	<ul style="list-style-type: none"> • Inspector task certified by supervisor to complete inspection • Inspector successfully identified cracks in similar inspection on three previous occasions.
2.2.2.2 Inspector rushed	<ul style="list-style-type: none"> • Supervisor reports inspector was late • Maintenance chief stated mission delayed due to late inspection

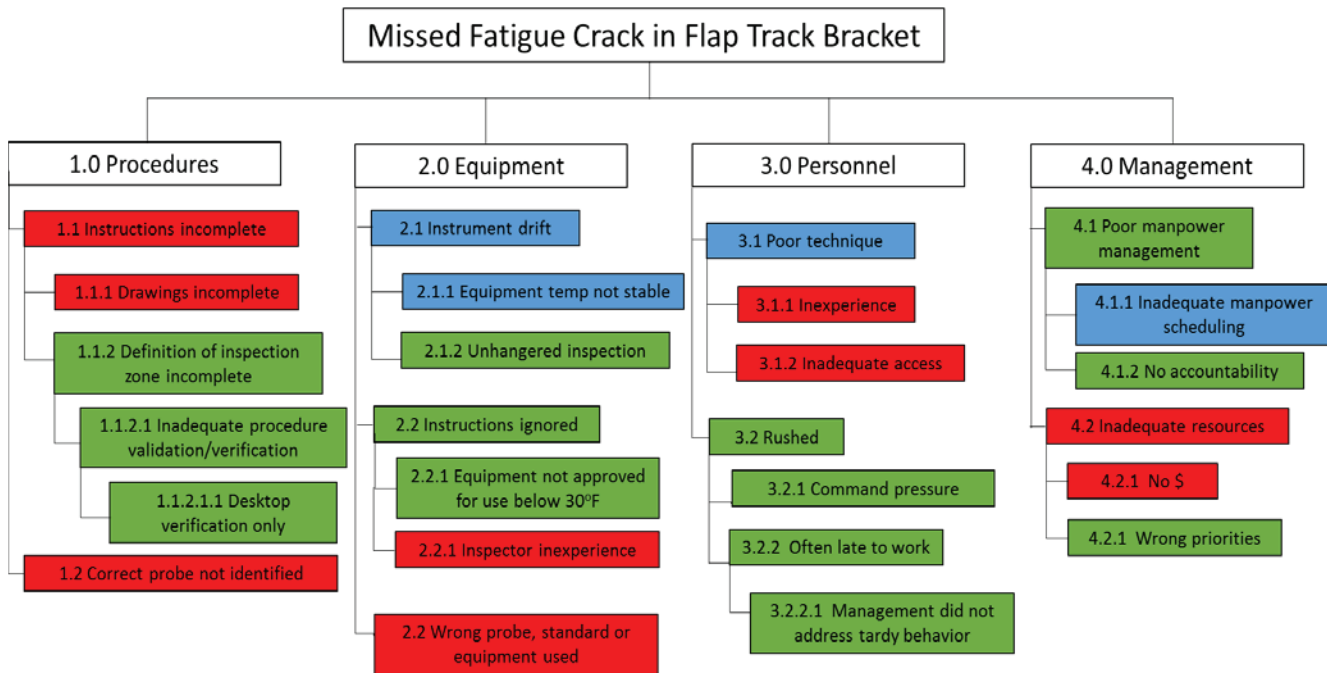
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Figure C-7. Example of color coded and numerically ordered Cause and Effect Diagram and supporting spreadsheet. On the Equipment breakdown is shown in this supporting spreadsheet.

g. Analyze the diagram. Analysis helps identify causes that warrant further investigation.

- Look for causes that are repeated.
- Look for causes that are clearly validated by evidence.
- Identify causes that are actionable and can be corrected.

C.12.2 Alternate Approach for Charting Cause and Effect . An alternate approach for graphically depicting the same information presented in the Cause and Effect Diagram is illustrated in [Figure C-8](#). The chart illustrates an inverted “tree” diagram which may be useful for briefing leadership. In this example all four categories contain “greens” which are contributing causes that should be addressed in subsequent corrective actions.



H2019025

Figure C-8. Example of Cause and Effect Tree Diagram

C.13 EXAMPLE INCIDENT SUMMARY REPORT.

C.13.1 Incident Description. A 30 day time compliance technical order (TCTO) was released requiring the eddy current inspection of the wing flap track on a dual engine US Air Force aircraft. The TCTO tech data was released with only a desktop validated and verification performed by the depot NDI and structural engineering prior to TCTO release. The TCTO was scheduled to be accomplished on 21 December 2004, on A/C 90-678 prior to a scheduled 7:00 AM training mission. The aircraft was grounded pending successful performance of the TCTO. The inspector assigned to the inspection task was late arriving to work. No other inspection personnel were available at the time due to holiday vacations. To expedite flight preparations, the crew chief rolled the aircraft out of the hangar at 8:00 AM to perform an engine check. At 9:35 AM the inspector arrives at work and is assigned the task by his supervisor. At 10:05 AM the inspector arrives at the aircraft and performs the inspection. The outdoor ambient temperature was 25°F with light winds at the time of the inspection. The indoor ambient condition where the inspection equipment was stored was 65°F. On 27 February 2005 at 5:32PM, A/C 90-678, experienced an in-flight failure of the left engine, declared an in-flight emergency and landed safely at a local municipal airport. The incident was classified as a Class A mishap as it resulted in greater than \$5M of damage to the aircraft and engine. A subsequent failure analysis revealed that the left-wing flap-track failed, resulting in the in-flight liberation of a mounting bracket. The bracket was ingested by the engine, resulting in FOD damage and engine failure. Laboratory analysis indicted the

flap track bracket failed due to fatigue. Analysis also indicates that the fatigue crack was estimated to be between a_{NDI} and $a_{critical}$ at the time of the previous inspection.

C.13.2 Findings. The resulting investigation revealed that the inspector violated procedural requirements and elected to ignore TCTO requirements for aircraft hangaring during inspection. Furthermore the inspector did not allow inspection equipment, probes and reference standard to reach ambient conditions prior to beginning the inspection. Interviews with the inspector indicate some confusion with the TCTO instructions regarding the correct inspection zone. A review of the TCTO with a qualified NDI Level 3 verified the diagrams describing the inspection zone did not match the written instructions which could lead to misinterpretation. Due to schedule and pervasive command pressures the inspector elected to complete the inspection with the even with the uncertainty with the TCTO instructions. No other qualified and experience inspectors were available for consultation. Failure to inspect the correct inspection zone ultimately led to the miss of a fatigue crack with length greater than a_{NDI} that grew to failure before the next scheduled inspection.

C.14 CAUSE DESCRIPTION.

C.14.1 Direct Cause. The inspector misinterpreted technical data instructions and inspected the incorrect zone.

C.14.2 Contributing Causes.

1. The inspection procedures did not clearly and unambiguously define the inspection zone. The structural diagrams did not fully match the written instructions defining the inspection zone.
2. The inspector was pressured to rush the inspection.
3. The inspector elected to violate procedures and perform an unhangared inspection.

C.14.3 Root Causes.

1. Engineering and the responsible NDI Level 3 did not ensure complete validation and verification of the inspection procedures prior to their release.
2. The supervisor did not ensure sufficient manpower to meet mission needs and hold personnel accountable.
3. The overarching organizational structure emphasized schedule over safety.

C.14.4 Corrective Actions.

1. Establish policy to ensure full validation and verification of all Safety-Critical technical data to include participation by technicians who perform the inspections.
2. Seek efficiencies in other operations to free up additional time for inspection.
3. Conduct manpower review to assess availability of qualified personnel to meet mission needs.
4. Establish and enforce policies to establish inspection as a Safety-Critical event that will drive schedules.
5. Hold management accountable for manpower availability and accountability.
6. Train personnel on the role of inspections to maintain flight safety and the critical nature of the task.
7. Emphasize a Safety-First culture.

GLOSSARY

A

ABSOLUTE (ET): — Refers to measurements made without a direct reference in contrast to differential measurements. Absolute measurements are affected by any change in electromagnetic properties; differential measurements are affected by differences between the test area and a comparative standard or adjacent areas on the tested part.

ABSOLUTE PROBE: — A probe containing a coil that responds to all electromagnetic properties of the test part.

ABSORBED DOSE: — The energy imparted by ionizing radiation per unit mass of irradiated material. The units of absorbed dose are the rad and the gray (Gy).

ABSORPTION COEFFICIENT (RT): — A fraction expressing the decrease in the intensity of a beam of radiation per unit thickness (linear absorption coefficient), or per atom (atomic absorption coefficient of the medium through which the radiation is passing).

ABSORPTION (PT): — The process of one material (liquid, solid, or gas) merging with a second material by penetration into the particles of the second material... as opposed to adsorption where the material coats and is retained on the surface of the particles of the second material.

ABSORPTION (RT): — The process whereby the particles or quanta (see PHOTON) in a beam of radiation are reduced in number or energy as they are passed through some medium. The particles lose energy by interaction with either the nucleus (core) or electron (shell) of the atoms of the medium.

ADSORPTION (PT): — The process of one material (liquid, solid, or gas) merging with a second material by coating and being retained on the surface of the particles (and interstices) of the second material... as opposed to absorption where the material penetrates into the particles of the second material.

ACCELERATOR: — A device that accelerates charged atomic particles to high energies. An X-ray machine or a betatron is an accelerator.

ACOUSTIC IMPEDANCE (UT): — A material property, which determines the product of the velocity of sound in a material and the density of the material used in determining the reflection characteristics of interfaces.

ACTIVITY: — A measure of how radioactive a particular radioisotope is. Activity is calculated by the number of atoms disintegrating per unit of time. Its unit of measurement is the curie. See SPECIFIC ACTIVITY.

ADDITIVE, ABSORPTIVE (RT): — See CONTRAST AGENT.

ADHERENCE: — The extent to which a coating bonds to a substrate.

ADHESION: — The adhering or sticking together of substances in contact with each other.

AGE HARDENING: — Increasing the hardness and possible strength of an alloy by a relatively low-temperature heat treat-

ment that causes precipitation of components or phases of the alloy from the supersaturated solid solution. Also known as precipitation hardening.

AGGLOMERATION (PT) (MT): — An indiscriminately formed mass. A cluster of disparate elements.

AGING: — A metallurgical change in a metal alloy resulting in an increase in mechanical properties. This change can occur in some instances at room temperatures. More often its effects are increased by holding for specified lengths of time at elevated temperatures. Also known as precipitation hardening.

AIR-COOLED TUBE (RT): — An X-ray tube for which the principal method of cooling is dissipation of heat into surrounding air.

AIR GAP (MT): — When a magnetic circuit contains a small gap that the magnetic flux must cross, the space is referred to as an air gap. Cracks produce small air gaps on the surface of a magnetized part.

ALARA: — (acronym for "as low as is reasonably achievable") means making every reasonable effort to maintain exposures to radiation as far below dose limits as is practical consistent with the purposes for which the radiation exposure is received, taking into account the state of technology, the economics of improvements in relation to benefits to the public health and safety, and other societal and socioeconomic considerations, and in relation to utilization of radiation in the public interest.

ALCLAD ALUMINUM: — A term applied to aluminum alloy sheet and wire products to which a thin coating of high purity aluminum or aluminum alloy of different composition has been bonded for corrosion protection.

ALIASING (RT/CR): — Image artifacts that appear when the spatial frequency of the input is higher than the output is capable of reproducing. Typically appear as jagged/stepped sections in a line or as moire patterns.

ALLOY: — A metal composed of two or more chemical elements at least one of which is a metal.

ALLOY STEEL: — Steel that has had sufficient quantities of alloying elements added to produce desired changes in the mechanical or physical properties.

ALLOY SYSTEM: — A complete series of compositions produced by mixing in all proportions any group of two or more components, at least one of which is a metal.

ALLOYING ELEMENT: — An element added to a metal to create a desired change in its properties.

ALPHA PARTICLE (RT): — A positively charged particle emitted by certain radioactive materials. It is made up of two neutrons and two protons; hence it is identical with the nucleus of a helium atom.

ALPHA "RAY" (RT): — A stream of fast moving helium nuclei. This is a strongly ionizing radiation with very weak penetration.

ALTERNATING CURRENT: — Alternating current is current that reverses its direction of flow at regular intervals. Such current is frequently referred to as AC

ALUMINUM EQUIVALENT (RT, UT): — The thickness of aluminum having a specified purity, affording the same attenuation, under specified conditions, as the material in question.

AMPERAGE: — The strength of a current of electricity measured in amperes.

AMPERE: — This is the unit of electrical current. One ampere is the current that flows through a conductor having a resistance of one ohm, at a potential of one volt.

AMPERE TURNS (MT): — This term refers to the product of the number of turns in a coil and the number of amperes of current flowing through it. This is a measure of the magnetizing or demagnetizing strength of the coil. For example: 800 amperes in a 6 turn coil = $800 \times 6 = 4800$ ampere turns.

AMPLIFIERS: — Circuit components that increase the magnitude of an electronic signal.

AMPLITUDE: — The extent of vibratory movement measured from the mean position to an extreme; the maximum departure of alternating voltage or current from the average value; indicated by vertical height on an A-scan presentation.

AMPLITUDE ECHO (UT): — The total vertical or pulse height of the received signal indicated by "A" scan presentation.

AMPLITUDE RESPONSE: — That property of the test system whereby the amplitude of the detected signal is measured without regard to phase.

ANGLE BEAM (UT): — A sound beam traveling at some angle other than normal to the surface of the test object. Measured from normal incidence.

ANGLE OF INCIDENCE (UT): — The angle defined by the direction of propagation of refracted wave and the normal to the interface at the point of incidence.

ANGLE OF REFLECTION (UT): — The angle defined by the direction of propagation of refracted wave and the normal to the interface at the point of incidence.

ANNEAL: — Heating metal to above its critical temperature range, then slowly cooling to remove stresses, induce softness, remove gases, alter ductility, induce toughness, or modify electrical, magnetic or other physical properties.

ANODE (TARGET) (RT): — The positive terminal of an X-ray tube. It is a high atomic number, high melting point element, and receives the electron bombardment from the cathode or negative terminal.

ANODE CURRENT (RT): — See TUBE CURRENT.

ANODIZING: — Forming a coating on a metal surface by anodic oxidation; most frequently on aluminum.

AREA MONITORING (RT): — The continued measurement of ionizing radiation exposure or dose levels in an area for the purpose of radiation protection.

AREA OF INTEREST (RT): — The specific portion of the specimen image on the radiograph that is to be evaluated.

ARTIFACT (RT): — Film blemishes produced during the manufacture, packaging, handling, or processing of film which are not associated with the actual condition of the material tested. They appear as white or black crescents, fogging, staining, etc.

A-SCAN (UT): — A data presentation method by which intelligence signals from a signal object located are displayed. As generally applied to pulse echo ultrasonics, the horizontal and vertical sweeps are proportional to time or distance and amplitude or magnitude respectively. Thus the location and magnitude of acoustical interface are indicated as to depth below the transducer.

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ASTM: — Abbreviation for American Society for Testing and Materials.

ASTM BLOCK: — Specific type of reference standard, cylindrically shaped and having a specified size FBH at a specified metal travel distance from the top of the block. See ASTM.

ATOM: — The smallest particle of an element that can enter into a chemical combination. All chemical compounds are formed of atoms, the difference between compounds being attributable to the nature, number and arrangement of their constituent atoms.

ATOMIC MASS: — Total mass of an atom. Approximately the same as the atomic mass number or total protons and neutrons in an atomic nucleus.

ATOMIC NUMBER: — An integer that expresses the positive charge of the nucleus in multiples of the fundamental electronic charge. In present theory, it is the number of protons in the nucleus.

ATOMIC WEIGHT: — The relative weight of the atom of an element, referred to some element taken as a standard. An atomic weight of 16 for oxygen is the one usually adopted as a basis for reference.

ATTENUATION (RT): — Intensity reduction of ionizing radiation beam due to passage through matter.

ATTENUATION (UT): — Loss of energy caused by scattering of the sound beam within a material or at an interface or an electronic device in or attached to the instrument.

ATTENUATION COEFFICIENT (RT): — Average rate that a beam of radiation changes as it passes through a body.

AUTOTRANSFORMER (RT): — A special type of transformer in which the output voltage can be easily varied. The autotransformer is thus employed to adjust the primary voltage applied to the step-up transformer that produces the high voltage applied to the X-ray tube.

AVERAGE GRADIENT (RT): — (of a film) The steepness of the characteristic curve of a film. Usually measured as average gradient between two levels of density; e.g., the average gradient between a density of 0.25 and a density of 2.0 is the slope of a straight line connecting these points. Most X-ray films have a gradient of 2.5 to 4.0, and any film with a gradient over 1.0 amplifies the subject contrast.

B

BACKGROUND (PT, MT): — The surface of the test part upon which the indication is viewed. It may be the natural surface of the test part, or it may be the developer coating on the surface. This background may contain traces of unremoved penetrant, fluorescent or visible, which if present, can interfere with the visibility of the indication.

BACKGROUND FLUORESCENCE (PT): — Fluorescent residues observed over the general surface of the part during fluorescent penetrant inspection. It is usually due to poor emulsification or rinsing of the fluorescent penetrant, or due to excessive roughness of the surface causing entrapment of the fluorescent penetrant.

BACKGROUND NOISE (UT): — Extraneous signals caused by signal sources within the ultrasonic testing system, including the material in test.

BACKGROUND RADIATION (RT): — Radiation coming from sources other than the radioactive material or X-ray machines used in making an exposure. Such radiation is primarily due to cosmic radiation from outside the earth's atmosphere and leakage from nearby sources.

BACK REFLECTION (UT): — Signal from the far boundary of the test part.

BACKSCATTER (RT): — Secondary radiation that is deflected at angles greater than 90 degrees with respect to the original direction of motion. Such radiation should be filtered from the film, as they bring no information to the film and cause a reduction in contrast due to an increase in noise.

BAND PASS FILTER: — An electronic circuit which allows flow of signals of a specific frequency range but suppresses signals of both greater and smaller rates of response.

BANDWIDTH: — The range of a band of different frequencies; the number of hertz between the maximum frequency of the range and the minimum frequency of the range, usually measured between points of equal and stated amplitude levels.

BARRIER (PROTECTIVE) (RT): — Barrier of attenuating materials used to reduce radiation exposure.

BASE DENSITY (RT): — The slight density that is due only to the film base and the blue dye in it. It is measured with the emulsion layer removed, or on a film which has been fixed without prior development.

BASELINE (UT): — The horizontal trace across the A-scan CRT display for a no signal condition.

BATH (colloquial) (PT, MT): — (1) The liquid penetrant inspection materials (penetrant, emulsifier, developer) into which parts are immersed during the inspection process. (2) Penetrant materials retained in bulk in immersion tanks intended for re-use. (3) Term used to designate a suspension of ferromagnetic particles with oil or water.

BEAM: — A directed flow of energy into space or matter.

BEAM ANGLE (RT): — The smallest angle between the central axis of the radiation beam and the plane of the radiographic film.

BEAM DIVERGENCE (RT): — The solid angle of the beam of radiation as it emerges from the X-ray tube or gamma-ray exposure device.

BEAM QUALITY (RT): — An expression used to describe the penetrating power (energy spectrum) of a beam of radiation. The quality of an X-ray beam is usually expressed in terms of the half-value layer of some reference material, such as aluminum or copper.

BEAM SPREAD (UT): — Divergence of a sound beam as it travels through material.

BERNOULLI EFFECT (PT): — A law of hydrodynamics: a liquid will flow through a conduit at a constant velocity governed by the pressure. When a section of the conduit is decreased in size, the velocity of the liquid flow in the reduced section is increased. If a small opening is placed in the reduced section, a vacuum or suction will be created at the opening.

BETA PARTICLE (RT): — An electron or positron emitted from a nucleus during decay. The term "beta particle" is reserved for electrons and positrons.

BETA "RAY" (RT): — A stream of high speed electrons that is of nuclear origin. This radiation is more penetrating than alpha radiation, but it ionizes less strongly.

BETATRON (RT): — A circular electron accelerator that is a source of either high energy electrons or X-rays. The electrons are injected by periodic bursts into a region of an alternating magnetic field. After acceleration, the electrons are brought out

directly or directed against a target to produce X-rays.

BIT DEPTH: — The number “2” increased by the exponential power of the analogue-to-digital (A/D) converter resolution. (e.g. a 16-bit system may have a maximum bit depth of $2^{16} = 65536$)

BLACK LIGHT (PT, MT): — The term often used to describe electromagnetic radiation having wavelengths from 320- 400 nm. Typical units used in penetrant inspection provide an intensity of 100 to 150 foot-candles at 15 inches from the face of the filter and are used to excite fluorescent materials in a range visible to the eye. See also Ultraviolet A.

BLEED OUT (PT): — The action by which the penetrant exudes out of the discontinuities onto the surface of a component, due primarily to “capillary action” and to “blotting” or “soaking up” effect of the developer.

BLISTER: — A defect in metal on or near the surface, resulting from the expansion of gas in a subsurface zone. Very small blisters are called “pinheads” or “pepper blisters.”

BLOCKING: — See MASKING.

BLOTTING (PT): — The action of the developer in soaking up the penetrant from the surface of the discontinuity, so as to cause maximum bleed out of the dye penetrant for increased contrast and sensitivity.

BLOWHOLE: — A hole in a casting or a weld caused by gas entrapped during solidification. See POROSITY.

BLUR (RT): — See UNSHARPNESS; PENUMBRA.

BODY (PT): — The term used to describe the ability of a penetrant vehicle to maintain an adequate suspension of visible or fluorescent dye material.

BOLT HOLE PROBE (ET): — A probe coil(s) assembly used for electromagnetically inspecting the walls of fastener holes or other small holes of limited length.

BOLT HOLE SCANNER (ET): — An eddy current device designed to provide automatic, uniform inspection of walls of fastener holes.

BRAZING: — Joining of metals and alloys by fusion of nonferrous alloys that have melting points above 800°F, but lower than melting points of materials being joined.

BRIDGE CIRCUIT (ET): — An electrical circuit designed to pass only the changes in voltage or current flow through a system while eliminating the larger steady state component. Such circuits in eddy current inspection reflect the changes in the electromagnetic variables while eliminating the larger current from the readout.

BRITTLENESS: — The quality of a material that leads to crack propagation without appreciable plastic deformation.

BROAD-BANDED (UT): — Having a relatively large bandwidth; used to describe instruments having an initial pulse with a relatively wide bandwidth and an amplifier with response to a relatively wide range of frequencies; opposite of narrow-banded or tuned.

BROAD BEAM (RT): — An uncollimated beam containing scattered radiation as well as the primary beam.

B-SCAN (UT): — A data presentation method generally, applied to pulse echo techniques which yields a two dimensional view of a cross-sectional plane through the test piece. The horizontal sweep is proportional to the test piece, with the vertical sweep proportional to distance, showing the front and back surfaces and discontinuities between.

BUBBLER (UT): — See WATER DELAY COLUMN.

BUILD-UP (RT): — An increase in radiation transmitted through material because of forward scatter.

BURNING: — Extreme overheating makes grains excessively large and causes the more fusible constituents of steel to melt and run into the grain boundaries, or it may leave voids between the grains.

BURST: — Fissures or ruptures caused by rolling or forging improperly or at improper temperatures.

BY-PRODUCT MATERIAL (RT): — In atomic energy law, any radioactive material (except source or fissionable material) obtained in the process of producing or using source or fissionable material. Includes fission products and many other radioisotopes produced in nuclear reactors.

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CALCIUM TUNGSTATE (RT): — A fluorescent chemical compound which emits visible blue-violet light when activated by either X- or gamma radiation.

CALIBRATION: — The process of adjusting an instrument to accurately measure a dimension or other measurable characteristic. It is also a process by which one compares a standard with another standard of higher accuracy to ensure the former is within specified limits. Examples of measurable characteristics in NDI include thickness (dimension), conductivity, hardness and temperature.

CALIBRATION STANDARD: — A standard on which a calibration process is based. Calibration standards are used to adjust an instrument for measurement. The characteristic of interest in a calibration standard will derive, although often indirectly, from a NIST master standard. For critical measurements where high accuracy is required, the calibration standard should be traceable to a NIST master standard.

CAPILLARY ACTION (PT): — The tendency of certain liquids to travel or climb when exposed to small openings, cracks, fissure, etc., due to factors such as surface tension, cohesion, adhesion and viscosity.

CARBON STEEL: — Steel that does not contain significant amounts of alloying elements other than carbon. Also known as straight carbon, ordinary steel or plain carbon steel contains carbon up to 2%, also termed plain carbon steel or ordinary steel.

CARBURIZE: — To produce surface hardness on low carbon steels by heating above the critical range while in contact with a suitable material containing carbon.

CARRIER LIQUID (MT): — A term used colloquially to designate the liquid used to carry the magnetic substance for the wet process.

CASSETTE (RT): — A lightproof container used for holding the radiographic films in position during the radiographic exposure. These holders may or may not contain intensifying and/or filter screens.

CASTING: — (1) An object at or near finished shape obtained by solidification of a substance in a mold. (2) Pouring molten metal into a mold to produce an object of desired shape.

CASTING SHRINKAGE: — (1) "Liquid shrinkage" - the reduction in volume of liquid metal as it cools to the liquidus. (2) "Solidification shrinkage" the reduction in volume of metal from the beginning to ending of solidification. (3) "Solid shrinkage" - the reduction in volume of metal from the solidus to room temperature. (4) "Total shrinkage" - the sum of the shrinkage in parts (1), (2) and (3).

CATHODE (RT): — The negatively biased electrode of an X-ray tube from which the electrons are emitted to be accelerated to the anode.

CATHODE RAY (UT, RT): — A stream of electrons emitted by a heated filament and projected in a more or less confined beam under the influence of a magnetic and/or electric field.

CATHODE RAY TUBE (UT): — A vacuum tube, containing a screen, upon which signals are displayed; basic display device for an A-scan. Abbreviation is CRT.

CENTISTOKE: — A unit of kinematic viscosity. Water has a viscosity of about one centistoke.

CENTRAL CONDUCTOR (MT): — A conductor made of copper, aluminum, steel or flexible cable that is passed into or through an opening in a cylindrically-shaped part or other shapes when applicable for the purpose of establishing a circular field on the inside diameter.

CESIUM-137 (RT): — A radioactive isotope of the element cesium emitting beta particles having a half-life of 30 years.

CHAIN REACTION: — A reaction that stimulates its own repetition. In a fission chain reaction, a fission nucleus absorbs a neutron and fissions, releasing more than one additional neutron. These in turn can be absorbed by other fissionable nuclei, releasing more neutrons. A fission chain reaction is self-sustaining when the number of neutrons released in a given time interval equals or exceeds the number of neutrons absorbed.

CHARACTERISTIC CURVE (RT): — A curve which expresses film density as a function of log relative exposure. These curves are useful in determining exposure correction factors and to define the gamma characteristics of the film.

CHARACTERISTIC RADIATION (RT): — X-radiation consisting of discrete wavelengths which are characteristic of the emitting material.

CHATTER: — In machining or grinding, (1) A vibration of the tool, wheel or workpiece producing a wavy surface on the work. (2) The finish produced by such vibration.

CHECKS (CHECK MARKS): — Numerous, very small cracks in metal or other material caused in processing.

CHILL: — (1) A metal insert imbedded in the surface of a sand mold or core or placed in a mold cavity to increase the cooling rate at that point. (2) White iron occurring on a gray iron casting, such as the "chill" in the wedge test. (3) (Unfused chaplets) A uniform line or band outlining the object and indicating the lack of fusion between the metal and the casting.

CIRCULAR MAGNETIZATION (MT): — When an electric current is passed through a solid magnetic conductor, a circular magnetic field is developed not only around the conductor, but also within the conductor.

CLADDING: — A process wherein a metallic coating is applied to a base metal by simultaneously rolling the base metal and the cladding material.

CLEAN: — Free of solid or liquid contamination from the surface or in the voids of the flaw that may interfere with the pen-

etration of the dye penetrant into the flaws, or with the occurrence of the inspection process.

CLEARANCE: — (1) The gap or space between two mating parts. (2) Space provided between the relief of a cutting tool and the surface cut.

CLEARING TIME (RT): — The time required for the first stage of fixing during which the whiteness (opaqueness) of the film disappears.

COBALT-60 (RT): — A radioisotope of the element cobalt, emitting gamma rays with energies of 1.33 and 1.17 MeV, with a half-life of 5.3 years.

COEFFICIENT OF THERMAL EXPANSION: — The linear expansion or contraction per unit length per degree Fahrenheit between specified lower and upper Fahrenheit temperatures. If aluminum is involved, such values are multiplied by one million for easier reading.

COERCIVE FORCE (MT): — The value of the reversing magnetizing force necessary to bring the flux density back to near zero.

COHERENT SCATTER: — The result of Compton scattering in which the electron receives none of the energy from the primary radiation. The resultant scattered radiation is of the same energy as the incident beam.

COGNIZANT ENGINEERING ORGANIZATION: — The company, government agency or other authority responsible for the design, or end use, of the material or component for which nondestructive testing is required.

COIL (ET, MT): — One or more turns of conductor wound to produce a magnetic field when current passes through the conductor.

COIL IMPEDANCE (ET): — The total opposition to current flow through a coil and is represented by the ratio of the coil voltage to the coil current. This impedance is affected by the material within the magnetic field generated by the coil and is sometimes used to measure eddy current response.

COIL SHOT (MT): — A term used colloquially to indicate a shot of magnetizing current passed through a solenoid or coil surrounding a part, for the purpose of establishing a longitudinal field.

COIL SIZE (ET, MT): — The geometry or dimension of a coil; for example, length or diameter.

COLD CRACKS: — See CRACKS, COLD.

COLD SHUT: — (1) A discontinuity that appears on the surface of cast metal as a result of two streams of liquid meeting and failing to unite. (2) A portion of the surface of a forging that is separated, in part, from the main body of metal by oxide.

COLD WORK: — Permanent strain produced by an external force in a metal below its recrystallization temperature.

COLD WORKING: — Deforming metal plastically at a temperature lower than the recrystallization temperature.

COLLIMATOR (RT): — A device used to limit the size, shape, and direction of the primary radiation beam.

COLLIMATOR (UT): — A lens assembly attachment designed to reduce the ultrasonic beam spread.

COLLIMATION: — The process by which a divergent beam of energy or particles is converted into a parallel beam.

COLLOIDAL (MT): — A liquid suspension of solid particles in which the particles will not settle on standing.

COLLOIDAL SUSPENSION (MT, PT): — An intimate mixture of two substances, one of which, called the dispersed phase (or colloidal), is uniformly distributed in a finely divided state through the second substance, called the dispersion medium (or dispersing medium); the dispersion medium or dispersed phase may be gas, liquid, or solid. Also known as colloidal dispersion; colloidal system.

COLOR-CONTRAST DYE (PT): — A dye which can be used in a penetrant to impart sufficient color intensity to give good color contrast in indications against the background of the surface being tested, when viewed under white light.

COLOR-CONTRAST PENETRANT: — A penetrant incorporating a dye - usually nonfluorescent - sufficiently intense to give good visibility to flaw indications under white light.

COMPLETE FUSION: — Fusion that has occurred over the entire base-metal surfaces exposed for welding.

COMPOSITE FILTER (RT): — A filter of two or more materials chosen so that the longer wavelengths of a beam are readily absorbed, and within this range undesirable radiation transmission is avoided. The materials are usually arranged so that the second material filters secondary radiation produced in the first material and so on. A particular example is the "Thoriaeus Filter" which consists of 0.44 mm of tin, 0.25 mm of copper and 1 mm of aluminum in this order in the beam of radiation.

COMPOSITE PLATE: — An electrodeposit consisting of layers of at least two different compositions.

COMPOUND: — A chemical combination of elements.

COMPRESSIONAL WAVE (UT): — Waves in which the particle motion or vibration is in the same direction as the propagated wave. Same as longitudinal wave. See LONGITUDINAL WAVES.

COMPTON ABSORPTION (COMPTON EFFECT) (RT): — The reduction of the energy of an incident photon by its interaction with an electron. Part of the photon energy is transferred to the electron (Compton electron or recoil electron) and part is redirected as a photon of reduced energy.

COMPTON EFFECT (RT): — The glancing collision of an X-ray or gamma ray with an electron resulting in a gain of energy for the electron.

COMPTON SCATTERING (RT): — A process in which a photon transfers a portion of its energy to an orbital electron in matter and a lower energy photon is scattered at an angle to the original photon path.

COMPUTED TOMOGRAPHY (RT): — A method by which a radiograph of a predetermined interior plane of a thick material is obtained through the use of a computer. The images resulting from a series of exposures at different angles are stored and reconstructed into a single image by the computer.

CONCAVE: — Curved or rounded and hollow as the outer boundary of a spherical or circular form viewed from within; opposite of convex.

CONCENTRATE (MT): — A term used colloquially to designate the dry magnetic materials used to prepare a suspension. Also called Dry Concentrate.

CONCENTRATION TEST (MT): — The method used to determine the quantity of magnetic material in the suspension at any given time. Also known as settling test.

CONDENSER IONIZATION CHAMBER (RT): — An ionization chamber which, having been charged to a certain potential, can be irradiated and subsequently attached to an electrometer to measure the residual charge, whereby the exposure is determined.

CONDUCTIVITY: — This is the inverse of resistance, and refers to the ability of a conductor to carry current.

CONDUCTIVITY REFERENCE STANDARD (ET): — Sections of metallic materials with accurately measured electrical conductivity values in percent IACS. These standards are used to calibrate conductivity measuring eddy current instruments.

CONE (RT): — A lead diaphragm or cone placed on the tube head to limit the X-ray beam to a volume defined by a cone.

CONSTANT-POTENTIAL CIRCUIT: — A circuit, which is so, arranged to apply and maintain a substantially constant potential across an X-ray tube.

CONSTANT VOLTAGE (CONSTANT POTENTIAL) (RT): — A unidirectional voltage of essentially constant magnitude.

CONTACT HEAD (MT): — Electrode assembly used to clamp and support a part to facilitate passage of electrical current through the part for circular magnetization.

CONTACT METHOD (UT): — The inspection method in which the search unit face makes direct contact with the test part and ultrasonic energy is transmitted through a thin film of couplant.

CONTACT PADS (MT): — Replaceable metal pads, usually copper braid, placed on the contact heads to give good electrical contact, thereby reducing the possibility of damage to the part by arcing or burning.

CONTACT TESTING (UT): — Testing with transducer assembly in direct contact with material through a thin layer of couplant.

CONTACT TRANSDUCER: — A transducer that is coupled to a test surface either directly or through a thin film of couplant.

CONTAINER, GAMMA- RAY SOURCE (RT): — A device for housing radionuclides and giving a required degree of protection against radiation. (This may take the form of an exposure device or a storage container.)

CONTAMINATION (PT, MT): — Any material in the wet suspension other than the liquid vehicle and the magnetic material being used. This could be shop dust, lint, soil from improperly cleaned parts, oil, etc.

CONTAMINATION (RT): — The presence of unwanted radioactive matter, or the "Soiling" of object or materials with "Radioactive Dirt."

CONTINUOUS METHOD (MT): — The method in which the inspection medium is applied while the magnetizing current is on.

CONTINUOUS SPECTRUM (RT): — The characteristic radiation pattern that exhibits energies for an unbroken series of frequencies over a wide range.

CONTINUOUS WAVE (UT): — Steady generation of ultrasonic energy; opposite of pulsed.

CONTRAST (MT, PT, RT): — The difference in visibility between an indication and the surrounding surface.

CONTRAST, FILM (RT): — Change in density that results from a given change in incident radiation. Determined from the slope of the characteristic curve.

CONTRAST, RADIOGRAPHIC (RT): — The difference in density between an image and its immediate surroundings on a radiograph.

CONTRAST, SUBJECT (RT): — The ratio (or logarithm of the ratio) of the radiation intensities transmitted by selected portions of the specimen.

CONTRAST-TO-NOISE-RATIO (RT/CR): — Quotient of the digital image contrast and the averaged standard deviation of the linear pixel values.

CONTROL PANEL (RT): — A console or unit that contains the controls necessary to operate a radiation source and any ancillary equipment used for radiography.

CONTROLLED AREA (RT): — A defined area in which the occupational exposure of personnel to radiation or to radioactive material is under the supervision of an individual in charge of radiation protection. (This implies that a controlled area is one that requires control of access, occupancy, and working conditions for radiation protection purposes.)

CONVEX: — Curved or rounded as the exterior of a spherical or circular form viewed from without; opposite of concave.

COOLING CRACK: — See CRACKS, COOLING.

COOLING STRESSES: — Residual stresses resulting from non-uniform distribution of temperature during cooling.

CORE (MT): — In reference to an electromagnetic inspection, it is a laminated steel conductor located within the electrical winding of a hand-held yoke or probe. Also, laminated steel conductor used in conjunction with a magnetizing coil to produce a stronger collapsing field in induced current magnetization of ring-shaped parts.

CORROSION: — The deterioration of a metal by chemical or electrochemical reaction with its environment or other material.

CORROSION FATIGUE: — Effect of the application of repeated or fluctuating stresses in a corrosive environment characterized by shorter life than would be encountered as a result of either the repeated or fluctuating stresses alone or the corrosive environment alone.

COULOMB: — A unit of electric charge in the "practical" system of units. It contains 3×10^9 electrostatic units of charge.

COUPLANT (UT): — A substance (usually liquid) used between the search unit and test part to permit or improve transmission of ultrasonic energy into the test part.

COUPLING (ET): — An interaction between systems or between properties of a system.

CRACK: — A discontinuity that has a relatively large cross-section in one direction and a small or negligible cross-section

when viewed in a direction perpendicular to the first.

CRACKS, COLD: — A crack, which occurs in a casting after solidification, due to excessive strain generally resulting from non-uniform cooling.

CRACKS, COOLING: — In bars of alloy or tool steels, are the result of uneven cooling after rolling and usually are deep in a longitudinal direction, but, are not straight.

CRACKS, FATIGUE: — Progressive cracks which develop in the surface caused by the repeated loading and unloading of the part, or by what is called reverse bending.

CRACKS, FORGING: — Cracks developed in the forging operation due to forging at too low a temperature, resulting in rupturing of the steel.

CRACKS, GRINDING: — Thermal cracks due to local over-heating of the surface being ground, generally caused by lack of coolant, improper coolant, dull wheel, too rapid a feed, or too heavy a cut.

CRACKS, HOT: — Same as CRACKS, COLD, but developing before the casting has completely cooled.

CRACKS, MACHINING: — A surface defect generally called machining tear and caused by too heavy a cut, a dull tool, chatter, or dragging the tool over the metal when not cutting cleanly.

CRACKS, PLATING: — A crack developed by the plating process, usually occurring in parts having high internal stresses.

CRACKS, QUENCHING: — Ruptures produced in the tempering of metal, due to uneven cooling and contracting of one portion of a part.

CRACKS, SERVICE: — Ruptures that occur on a part after all fabrication has been completed and the part placed in service. Failure may be due to fatigue, corrosion, overstraining, or undetected processing discontinuities.

CRATER: — (1) In machining, a depression in a cutting tool face eroded by chip contact. (2) In arc welding, depressions at the termination of a bead or in the weld pool beneath the electrode.

CREEP: — Time-dependent strain occurring under stress. The creep strain occurring at a diminishing rate is called primary creep; that occurring at a minimum and almost constant rate, secondary creep; that occurring at an accelerating rate, tertiary creep.

CRITICAL ANGLE (UT): — The angle of the incident sound beam with respect to the normal to an interface, beyond which a given mode of refracted beam will not exist.

CRITICAL SIZE: — The established flaw size deemed to be detrimental to the serviceability of the product criteria. The acceptance/rejection levels established by design engineering required limits to meet design performance.

CRYSTAL (UT): — See TRANSDUCER ELEMENT.

CRYSTALS (X-CUT) (UT): — Section cut so that its thickness is parallel to the X-axis of the crystal. A thickness- extensional mode of vibration occurs when excited.

CRYSTALS (Y-CUT) (UT): — Section cut so that its thickness is parallel to the Y-axis of the crystal. A thickness- shear mode of vibration occurs when excited.

CRYSTALS (Z-CUT) (UT): — Section cut so that its thickness is parallel to the Z-axis of the crystal. Piezoelectric effect is restricted to the X and Y-axis; therefore mode of vibration is width-extensional.

C-SCAN (UT): — A data presentation method generally applied to pulse echo techniques yielding a two dimensional plan view of the scanned surfaces of the part. Through gating, only echoes arising from the interior of the test object are indicated. In the C-scan no indication is given of the echo depth.

CUMULATIVE DOSE (RADIATION) (RT): — The total dose resulting from repeated exposure to radiation of the same region or of the whole body.

CURIE (RT): — A unit of measure to express the rate at which a radioactive material decays. It is defined as that quantity of any radioactive material in which 3.7×10^{10} disintegrations per second are occurring. Under the International System (SI) of Units, the curie will be replaced by disintegrations per second (1 Curie = 3.70×10^{10} disintegrations per second).

CURIE POINT (MT): — The temperature at which ferromagnetic materials become nonmagnetic and can no longer be magnetized by outside sources. The range of temperatures is 1200°F-1600°F.

CURRENT: — The flow of electrons through a conductor. It is measured in amperes, milliamperes or microamperes.

DAMPING: — Hindering or decreasing the time of vibrations or oscillations in the motion of a body or in an electrical system subjected to influences which are capable of causing vibration or oscillation. Compare with attenuation.

DAMPING (UT): — Limiting the duration of and/or decreasing the amplitude of vibrations, as in damping of a transducer element; also designates a bond inspection method in which good bonds are verified by damping ultrasonic energy transmitted to the back surface.

DAMPING MATERIAL (UT): — Material contained within a search unit in back of the transducer element and used for damping.

DARK ADAPTATION: — The ability of the eye to adjust so that objects, lights, or colors can be seen in darkened areas. This is important when performing a fluorescent penetrant, fluorescent magnetic particle inspections or when interpreting radiographic film.

DC (DIRECT CURRENT): — An electrical current that flows continually in one direction through a conductor.

DEAD ZONE: — Zone in the test part directly underneath the sound entry surface where discontinuities cannot be detected; caused by the finite length of the initial pulse, ringing time of the transducer element, and/or electronic characteristics of the instrument.

DECAY (MT): — The falling off to zero of the current in an electrical circuit. Magnetic fields can also decay in a similar manner. This is important in demagnetization.

DECAY (RT): — Spontaneous change of a nucleus with emission of a particle or a photon. For a definite quality of a nuclide, the rate of decay is usually expressed in terms of half-life.

DECIBEL: — Logarithmic expression of a ratio of two amplitudes; abbreviation is dB. $dB = 20 \log_{10} (A_2/A_1)$, where A_1 and

A2 are amplitudes. The abbreviation is dB.

DEEP-DOSE EQUIVALENT: — Applies to whole-body exposure, is the dose equivalent at a tissue depth of 1 cm (1000 mg/cm²)

DEFECT: — A discontinuity that interferes with the usefulness of a part. A fault in any material or part detrimental to its serviceability. Note that all cracks, seams, laps, etc. are not necessarily defects as they may not affect serviceability of the part in which they exist.

DEFECT DETECTION SENSITIVITY (RT): — See SENSITIVITY, DEFECT.

DEFECT ORIENTATION (PT, MT): — The position of the defect in relation to the inspection surface and the magnetic or penetrant indication.

DEFINITION, RADIOGRAPHIC (RT): — A general and qualitative term that refers to the degree of distinctness of image details in a radiograph, photographic reproduction, or viewing-screen image. Measure of sharpness of an outline in the radiographic image of an object. Radiographic definition is a function of the types of screens, exposure geometry, radiation energy, and the film characteristics.

DELAMINATION: — An area of separation between two laminae in the finished laminate.

DELAY (UT): — See SWEEP DELAY.

DELAY COLUMN (UT): — See WATER DELAY COLUMN.

DELAY LINE (UT): — Material (liquid or solid) placed in front of the search unit to cause a time delay between the initial pulse and front surface signal.

DELAYED SWEEP (UT): — An A-scan or B-scan presentation in which an initial part of the time scale is not displayed.

DEMAGNETIZATION (MT): — The reduction in the degree of residual magnetism in ferromagnetic materials to an acceptable level.

DENDRITE: — A crystal that has a tree-like branching pattern being most evident in cast metals slowly cooled through the solidification range.

DENSITOMETER: — Instrument utilizing the photoelectric principle to determine the degree of darkening of developed photographic film. Measures optical density of films.

DENSITOMETRY (RT): — The measurement of the degree of darkening of a developed photographic/radiographic film, providing one measure of the quality of the film. Measuring the optical density of films.

DENSITY STRIP (RT): — A strip of processed film having a stepwise array of increasing photographic density. This film may be nationally recognized standardizing body for standardizing densitometers.

DENSITY COMPARISON STRIP OR DENSITY STRIP (RT): — A strip of processed film carrying a stepwise array of increasing photographic density.

DENSITY, FILM (RT): — The degree of blackening of a film is density. Film blackening or density is usually expressed in terms of the H & D curve (Hurter & Driffield) which is defined as the logarithm of the reciprocal of the transparency of the film. $D = \log I_o/I_t$, where D = density, I_o = Light incident on the film, and I_t = Light intensity transmitted.

DEOXIDIZING: — (1) The removal of oxygen from molten metals by use of suitable deoxidizers. (2) Sometimes refers to the removal of undesirable elements other than oxygen by the introduction of elements or compounds that readily react with them. (3) In metal finishing, the removal of oxide films from metal surfaces by chemical or electrochemical reaction.

DEPTH OF PENETRATION (MT, EC): — The depth at which the magnetic field or induced eddy currents has decreased to a specified percentage of its surface value or has reached the limit of its effectiveness. The depth of penetration is an exponential function of the frequency of the signal and the conductivity and permeability of the material.

DESCALING: — Removing the thick layer of oxides formed on some metals at elevated temperatures.

DETAIL (RT): — See DEFINITION, RADIOGRAPHIC.

DETAIL SENSITIVITY (RT): — The radiographic definition or sharpness of detail as indicated by the drilled holes in a penetrometer. It is expressed by a number $x-yT$, where x is the thickness of the penetrometer expressed as a percentage of the nominal subject thickness, and y is the diameter of the hole expressed as a multiple of the penetrometer thickness T .

DETECTOR (RT): — A device that determines the presence of ionizing radiation.

DEVELOPER DRY (PT): — A light fluffy dry absorbent powder, applied to the part being penetrant inspected after the excess surface penetrant has been removed and the part has been dried. The "Dry" developer adheres primarily to the flaw openings wetted by the penetrant liquid, to obtain increased bleed out of the penetrant and provide sharp flaw delineations.

DEVELOPER (PT): — Material, wet or dry, which will draw or absorb penetrant from a surface crack or defect to the extent the defect will be visible under natural, artificial, or UV-A, as applicable. Developers also control the background of the high contrast penetrant color system.

DEVELOPER (RT): — A chemical solution that reduces exposed silver halide crystals to metallic silver.

DEVELOPER, NONAQUEOUS (PT): — Absorbent powdered materials suspended in a non-aqueous liquid, used to provide a white background for maximum color contrast, and to enhance the bleed out of the penetrant from the flaw cavity to obtain increased accuracy of penetrant inspection.

DEVELOPER, SOLUBLE (PT): — A developer completely soluble in its carrier, not a suspension of powder in a liquid, which dries to an absorptive coating.

DEVELOPER, SOLVENT: — A developer consisting of fine particles suspended in a volatile solvent. The volatile solvent helps dissolve the penetrant out of the discontinuity and bring it to the surface.

DEVELOPER, WET (PT): — An absorbent powder supplied in the dry form to be mixed and suspended in water for application to the part being penetrant inspected, after the excess surface penetrant has been removed. The "Wet" developer, on drying, provides an absorbent white background to the part for maximum color contrast, and enhances the bleed out of the penetrant from the flaw cavity to obtain increased inspection accuracy.

DEVELOPING AGENT (RT): — The constituent of a developer that reduces sufficiently exposed silver halide grains to metallic silver at a greater rate than unexposed or insufficiently exposed grains.

DEVELOPING TIME (PT): — The elapsed time necessary for the applied developer to bring out indications from penetrant entrapments. Usually one-half the penetrant dwell time.

DEVELOPMENT (RT): — The conversion of a latent image into a visible image by treatment of the film emulsion with a suitable chemical solution (developer).

DIAMAGNETIC: — A material that has less magnetic permeability than that of a vacuum. Although diamagnetic materials have relative magnetic permeabilities slightly less than 1, the amount of difference is insignificant in eddy current testing and diamagnetic material are classified as nonmagnetic with a relative permeability of 1.

DICHROIC FOG (RT): — Fog caused by the deposition of a very thin layer of finely divided silver on an emulsion, which when examined in white light, appears in two colors, red by transmission and green by reflection.

DIE: — Various tools used to impart shape to material primarily because of the shape of the tool itself. Examples are blanking dies, cutting dies, drawing dies, forging dies, punching dies, and threading dies.

DIFFERENTIAL COILS; PROBES (ET): — Two or more coils electrically connected in series opposition such that any electromagnetic condition which is not common to the areas of the specimen being tested or the test specimen and the standard will produce an unbalance in the system and thereby be detected.

DIFFRACTION (RT): — The scattering of incident radiation from the regularly spaced atoms in crystals or complex molecules such that interference between the scattered waves results in a pattern of maxima and minima in the intensity of the scattered radiation.

DIFFRACTION (UT): — The deflection of a wave front when passing the edges of an obstacle.

DIFFUSE INDICATIONS (MT): — Indications of some sub-surface indications that are broad, fuzzy, feathery and are not clearly defined.

DIFFUSION: — (1) Spreading of a constituent in a gas, liquid or solid, tending to make the composition of all parts uniform. (2) The spontaneous movement of atoms or molecules to new sites within a material.

DIGITAL DYNAMIC RANGE (RT/CR): — Maximum material thickness latitude that renders acceptable levels of specified image quality performance within a specified pixel intensity value range.

DIGITAL IMAGE CONTRAST (RT/CR): — Pixel value difference between any two areas of interest within a computed radiograph.

DIGITAL IMAGE NOISE (RT/CR): — Imaging information within a computed radiograph that is not directly correlated with the degree of radiation attenuation by the object or feature being examined and/or insufficient radiation quanta absorbed within the detector imaging plate.

DIGITAL IMAGE PROCESSING (RT/CR): — The use of algorithms to change original digital image data for the purpose of enhancement of some aspect of the image.

DIRECT CURRENT: — Electric current flowing continuously in one direction through a conductor. Such current is frequently referred to as DC.

DISBOND: — An area within a bonded interface between two adherends in which an adhesion failure or separation has occurred.

curred. It may occur at any time during the life of the structure and may arise from a wide variety of causes.

DISCONTINUITY: — An interruption in the normal physical structure or configuration of a part such as cracks, laps, seams, inclusions, porosity. A discontinuity may or may not affect the usefulness of a part. See DEFECT.

DISINTEGRATION, NUCLEAR: — A spontaneous nuclear transformation (radioactivity) characterized by the emission of energy and/or mass from the nucleus.

DISLOCATION: — A linear defect in a crystal or lattice of a material. The two basic types are edge and screw.

DISPERSANT (PT): — A substance for promoting the formation and stabilization of dispersed particles of one substance in another.

DISTANCE AMPLITUDE CORRECTION (UT): — Compensation for variance in amplitude from equal reflectors at different sound travel distances. The abbreviation is DAC. Also used to denote electronic change of amplification to provide equal amplitude from equal reflectors at different sound travel distances. Other designations for this electronic change of amplification are Swept Gain (SG), Time Corrected Gain (TCG), Time Variable Gain (TVG) and Sensitivity Time Control (STC).

DOSE OR RADIATION DOSE: — A generic term that means absorbed dose, dose equivalent, etc. And represents the total amount of radiation received during the applicable period of exposure.

DOSE EQUIVALENT: — The product of the absorbed dose in tissue, quality factor, and all other necessary modifying factors at the location of interest. The units of dose equivalent are the rem and Sievert (Sv).

DRY DEVELOPER (PT): — A developer powder that is applied as a dust without a liquid carrier.

DRYING OVEN (PT): — An oven used for drying rinse water from test pieces.

DRYING TIME (PT): — The time during which a washed or wet-developed part is in the hot air drying oven.

DRY METHOD (MT): — Magnetic particle inspection in which the particles are applied in a dry powder form.

DRY POWDER (MT): — Finely divided ferromagnetic particles suitably selected and prepared for magnetic particle inspection. Colors employed are usually red, gray, yellow or black.

DUAL TRANSDUCER (UT): — A single search unit containing two transducer elements; one used as a transmitter of ultrasonic energy, the other used as a receiver of ultrasonic energy.

DUCTILITY: — The ability of a material to deform plastically without fracturing, being measured by elongation or reduction of area in a tensile test, by height of cupping in an Erichsen test or by other means.

DWELL TIME (PT): — The period of time wherein the liquid penetrant remains on the surface of the part. For the immersion techniques, the period subsequent to soak and prior to wash, i.e., draining process is considered dwell time.

DYE: — The chemical component added to a penetrant vehicle to provide a characteristic color to the penetrant.

DYE PENETRANT: — Penetrant with dye added that makes it readily visible in light.

E

ECHO: — Signal of reflected ultrasonic energy.

EDDY CURRENTS: — Currents caused to flow in an electrical conductor by the time and/or space variation of an applied magnetic field.

EDDY CURRENT INSPECTION OR TESTING: — A nondestructive inspection method in which eddy current flow is induced in the test object. Changes in the flow caused by the variations in the specimen are reflected into a nearby coil or coils for subsequent analysis by suitable instrumentation and techniques.

EDDY-SONIC (UT, ET): — Describes a process in which sonic or ultra-sonic energy is produced in a test part by coil on or near the surface of the test part. The coil is used to produce eddy currents in the test part. Vibrations in the test part result from the interaction of the magnetic field from the eddy currents in the test part with the magnetic field of the coil.

EDGE EFFECT (ET): — The effect on the magnetic field caused by the geometric boundaries of the test specimen. The effect is large in magnitude and similar in phase to a large crack. Also called end effect when applied to bar or tubing.

EFFECTIVE DEPTH OF PENETRATION: — The depth within a material, under test, where the transmitted or induced energy is sufficient to detect discontinuities (determine condition of interest). EDP is approximately equal to three times standard DOP.

EFFECTIVE FOCAL SPOT (RT): — An elongated, rectangular electron focus so angled that the focal spot size, as viewed along the X-ray beam axis, is smaller and approximately square, thereby permitting increased total area loading of the target for a given focal spot size.

ELASTIC LIMIT: — The maximum stress to which a material may be subjected without any permanent strain remaining upon complete release of stress.

ELASTICITY: — That property of a material by virtue of which it tends to recover its original size and shape after deformation.

ELECTRICAL NOISE: — Extraneous signals caused by externally radiated electrical signals or from electrical interferences within the ultrasonic instrumentation.

ELECTROMAGNET: — A soft iron core surrounded by a coil of wire. The iron core becomes magnetic when an electric current flows through the wire.

ELECTROMAGNETIC INSPECTION OR TESTING (ET): — A nondestructive test method for engineering materials including magnetic materials, which use electromagnetic energy having frequencies less than those of visible light to yield information regarding the quality of test material. This term includes both eddy current testing and magnetoinductive testing.

ELECTROMAGNETIC RADIATION (RT): — Radiation consisting of electric and magnetic waves that travel at the speed of light. Examples: light, radio waves, gamma rays, X-rays. All can be transmitted through a vacuum.

ELECTROMAGNETIC SPECTRUM: — The wavelength range of the various forms of electromagnetic radiation.

ELECTROMOTIVE FORCE (EMF): — The work or energy that causes the flow of an electric current. Expressed as volts.

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It should be noted that the term "force" is a misnomer. However, the term is so well established that its use continues in spite of its being incorrect.

ELECTRON: — One of the fundamental constituents of atoms. The electron is a very small negatively charged particle with a rest mass of approximately 1/1836 that of the hydrogen atom, or 9.107×10^{-28} gm. It has an electric charge of 4.802×10^{-10} statcoulomb (the electrostatic unit of charge). Electrons appear to be uniform in mass and charge.

ELECTRON FOCUS (RT): — The surface of the intersection of the electron beam and the anode of the X-ray tube.

ELECTRON GUN (RT): — A device in which electrons (usually liberated from a hot filament) are focused and accelerated, and from which they are emitted as a narrow beam.

ELECTRON VOLT: — A unit of energy commonly used to express the energy of X-rays. One electron volt is the energy gained by an electron when it is accelerated by a potential difference of 1 volt ($1 \text{ eV} = 1.60210 \times 10^{-19}$ joule - SI).

ELECTROPLATING: — Electrodepositing metal in an adherent method upon a metal object serving as a cathode. Examples would be nickel chromium and cadmium deposits. Thicknesses under 0.005 do not interfere with magnetic particle inspection.

ELECTROSTATIC SPRAYING (PT): — A technique of spraying wherein the material being sprayed is given a high electrical charge, while the test piece is grounded.

ELEMENT: — One of the 118 known chemical substances that cannot be divided into simpler substances by chemical means. Examples: hydrogen, lead, and uranium.

ELEMENTARY PARTICLE: — Originally a term applied to any particle that could not be further subdivided; now applied only to protons, electrons, neutrons, antiparticles, and strange particles, but not to alpha particles and deuterons.

ELONGATION: — In tensile testing, the increase in the gage length, measured after fracture of the specimen within the gage length, usually expressed as a percentage of the original gage length.

EMBRITTLEMENT: — Reduction in the normal ductility of a metal due to a physical or chemical change.

EMBRYO/FETUS: — The developing human organism, from conception until the time of birth.

EMISSIVITY: — The energy emission rate usually expressed as r/c/hr @ 1 ft or mR/mc/hr @ 1 ft.

EMULSIFICATION (PT): — The process of dispersing one liquid in a second immiscible liquid; the largest group of emulsifying agents are soaps, detergents, and other compounds, whose basic structure is a paraffin chain terminating in a polar group.

EMULSIFIER (PT): — A liquid agent that must be applied to the non-water washable penetrant after the proper dwell time has elapsed to permit water rinsing. This requires an additional step and a period of time must be allowed for the combining to occur. A suspension of one liquid phase in another.

EMULSIFIER-REMOVER (PT): — A type of solvent that can be rinsed off with water after it is applied or used as a solvent wipe remover.

EMULSIFICATION TIME (PT): — Time required for the emulsifying agent to act on the penetrant. This is critical as in-

sufficient time will result in failure to remove the penetrant and lead to false indications, and too long a time may remove the penetrant from the flaws. Emulsification time usually ranges from 30 seconds to 5 minutes.

EMULSION (RT): — The gelatinous substance in which fine grains of silver halides are dispersed. The emulsion is coated on a base, usually polyester, and contains the image forming substance of a radiographic film.

ENCIRCLING COIL (MT, ET): — Coil(s) or coil assembly which surrounds the part to be tested. Coils of this type are also referred to as annular, circumferential, or feed-through coils.

ENERGY, RADIATION (RT): — The energy of X-radiation is generally expressed in multiples of the electron volt (1,000,000 eV = 1,000 KeV = 1 MeV).

EQUIVALENT PENETRATOR SENSITIVITY (RT): — The thickness of penetrator, expressed as a percentage of the part thickness, in which the 2T hole would be visible under the same radiographic conditions.

EROSION: — Destruction of metals or other materials by the abrasive action of moving fluids usually accelerated by the presence of solid particles or matter in suspension. When corrosion occurs simultaneously, the term erosion-corrosion is often used.

ET: — Symbol for eddy current method of nondestructive testing/inspection.

ETCHING: — Subjecting the surface of a metal to preferential chemical or electrolytic attack in order to reveal structural details.

EVALUATION: — The decision on whether a part should be rejected, salvaged or accepted for use based on the severity of the indication interpreted.

EXFOLIATION: — A type of corrosion that progresses approximately parallel to the outer surface of the metal, causing layers of the metal to be elevated by the formation of corrosion product.

EXPOSURE (RT): — The product of the X-ray intensity as measured by filament current in milliamperes and time in seconds or minutes for X-rays, or the product of source strength in curies and time in seconds or minutes for gamma rays. The exposure factor determines the degree of film blackening as long as the reciprocity law is valid. See RECIPROCITY LAW and RECIPROCITY LAW FAILURE.

EXPOSURE CHART (RT): — A graph showing the relation between material thickness, kilovoltage, and exposure. It is only adequate for determining exposure time for a uniform thickness of material.

EXPOSURE DEVICE (RT): — A shield in the form of a package designed to contain and allow the controlled use of one or more sealed sources for the purpose of making radiographic exposures.

EXPOSURE FACTOR (RT): — A quantity that combines milliamperage or source strength, time, and distance. Numerically, the exposure factor is the product of milliamperage and time divided by distance squared for X-rays and the product of curies and time divided by distance squared for gamma rays.

EXPOSURE METER (RT): — An instrument for measuring exposure (radiation quantity). May also contain an audible signal referred to as an alarming rate meter.

EXPOSURE RATE (RADIATION QUANTITY) (RT): — The exposure unit time. Special unit: roentgens per second.

EXPOSURE RATE METER (RT): — An instrument for measuring exposure rate (radiation quantity).

EXTERNAL DISCONTINUITIES: — Surface irregularities that cause density variations on a radiograph. These are observable with the naked eye.

EXTREMITY: — Means hand, elbow, and arm below the elbow; foot, knee, and leg below the knee.

EXTRUSION: — Conversion of a billet into lengths of uniform cross section by forcing the plastic metal through a die orifice of the desired cross-sectional outline.

FALSE INDICATIONS: — See NON-RELEVANT INDICATIONS.

FAMILY CONCEPT (PT): — See SYSTEM CONCEPT. The term "Family Concept" has been changed to "System Concept" to comply with DOD standardization requirements. The two terms have the same meaning.

FAR FIELD (UT): — Sound beam zone in which equal reflectors give signals of exponentially decreasing amplitude with increasing distance; zone beyond the near field; also known as the FRAUNHOFER ZONE.

FATIGUE: — The progressive fracture of a material that begins at a defect and increases under repeated cycles of stress. Fatigue fractures are progressive, beginning as minute cracks that grow under the action of the fluctuating stress.

FATIGUE CRACKS: — See CRACKS, FATIGUE.

FATIGUE LIFE: — The number of cycles of stress than can be sustained prior to failure for a stated test condition.

FATIGUE STRENGTH: — Maximum stress that a metal will withstand without failure for a specified number of cycles of stress.

FAYING SURFACE: — The surface of a piece of metal (or a member) in contact with another to which it is or is to be joined.

FERROMAGNETIC MATERIAL: — Materials that are strongly attracted by a magnetic field. Iron, steel, nickel, and cobalt are included in this category. Permeability is much greater than one, and is effected by the applied magnetic field. Such materials exhibit hysteresis behavior.

FERROUS METALS: — Containing iron, such as steel, stainless steel and cast iron.

FFD (RT): — Film focal distance; distance between film and tube target.

FIBER (FIBRE): — (1) The characteristic of wrought metal that indicates Directional Properties and is revealed by the etching of a longitudinal section or is manifested by the fibrous or woody appearance of a fracture. It is caused chiefly by the extension of the constituents of the metal, both metallic and nonmetallic, in the direction of working. (2) The pattern of preferred orientation of metal crystals after a given deformation process, usually wiredrawing.

FIELD, CIRCULAR (MT): — The magnetic field surrounding any magnetic conductor or part resulting from the current being passed through a central conductor or the part.

FIELD INDICATOR (MT): — A device for indicating the amount of magnetism in a part.

FIELD, LEAKAGE (MT): — The field that leaves or enters the surface of a part at a discontinuity or change in section configuration.

FIELD, LONGITUDINAL (MT): — A field created by a coil shot or cable wrap and in which the flux lines traverse the part essentially parallel with its longitudinal axis. A localized field, on the surface of a part, traversing from one leg of a yoke or probe to the other.

FIELD, MAGNETIC (MT): — The space within and surrounding a magnetized part or a conductor carrying current in which magnetic lines of force exists.

FIELD, RESIDUAL (MT): — The magnetism that remains in a piece of magnetizable material after the magnetizing force has been removed.

FIELD, RESULTANT (MT): — The magnetic field resulting when two or more magnetizing forces, operating in different directions, are applied to ferromagnetic materials.

FILAMENT (RT): — The source of electrons in a hot-cathode tube. It is usually a heated wire.

FILAMENT TRANSFORMER (RT): — A transformer supplying power to heat the filament of a hot-cathode. The primary and secondary windings must be sufficiently insulated to withstand the peak potential difference between the cathode and earth.

FILLET: — Radius imparted to the inside of two meeting surfaces.

FILL FACTOR (ET, MT): — The square of the ratio of the diameter of a part to the diameter of one encircling coil(s). The square of the ratio of the internal coil diameter to the bore diameter for internal probes. The fill factor is a measure of coupling between the encircling or internal coil and the test object.

FILM BADGE (RT): — A piece of masked radiographic film worn in the form of a badge that is used to measure exposure. The amount of exposure is determined from the degree of film blackening.

FILM BASE (RT): — A flexible, transparent, or translucent material that is coated with a photosensitive emulsion.

FILM CLEARING TIME (RT): — See CLEARING TIME.

FILM DENSITY (RT): — See DENSITY, FILM.

FILM GRAININESS (DIRECT X-RAY EXPOSURES) (RT): — The visual impression of irregularity of density, in areas where exposure is macroscopically uniform, due to the random spatial distribution of X-ray quanta absorbed in the film. In general, fast films exhibit greater graininess than slow films.

FILM HOLDER (RT): — A light-tight carrier for films and screens.

FILM ILLUMINATOR (RT): — A device incorporating a suitable source of illumination for viewing radiographs or other transparencies.

FILM LATITUDE (RT): — Latitude refers to the exposure range within which a satisfactory radiograph is produced. Films which have the widest latitude are those which have the lowest film gradient and therefore the lowest film contrast.

FILM PROCESSING (RT): — See PROCESSING, FILM.

FILM, RADIOGRAPHIC (RT): — A photographic film that is usually coated on both sides with an emulsion designed for use with X-rays and gamma rays.

FILM SPEED (RT): — A measure of the rate at which a film responds to a given amount of radiation. Slower films require a longer period of time to reach the same film density than a fast film under the same exposure conditions.

FILM UNSHARPNESS (RT): — See UNSHARPNESS.

FILM VIEWER (RT): — See FILM ILLUMINATOR.

FILTER (RT): — A layer of absorptive material which is placed in the beam of radiation for the purpose of absorbing rays of long wavelengths to control the quality of the radiograph.

FILTERS (UT, ET): — Filters are electrical circuits designed to eliminate various frequencies from a circuit output or input. Filter may be low pass (high frequencies suppressed), high pass (low frequencies suppressed) or band pass (frequencies outside a specified range suppressed).

FILTRATION: — See INHERENT FILTRATION.

FILTRATION (RT): — The use of a filter to alter the characteristics of a radiation beam.

FINE CRACK: — A discontinuity in a solid material with a very fine opening to the surface, but possessing length and depth greater than the width of this opening; usually depth is many times the width.

FINISH: — (1) Surface condition, quality or appearance of a metal. (2) Stock on a forging to be removed when finish machined.

FISSION: — The splitting of a heavy nucleus into two roughly equal parts (which are nuclei of lighter elements) accompanied by the release of a relatively large amount of energy and frequently one or more neutrons. Fission can occur spontaneously, but usually it is caused by the absorption of gamma rays, neutrons, or other particles.

FIT: — The amount of clearance or interference between mating parts.

FIXER (RT): — A chemical solution that removes unexposed silver halide crystals from film emulsion.

FIXING (RT): — The procedure used in film processing that removes all of the undeveloped silver salts of the emulsion from the surface of the film, thus leaving only the developed latent image.

FLAKES: — Short discontinuous internal fissures in ferrous metals attributed to stresses produced by localized transformation and decreased solubility of hydrogen during cooling after hot working. In a fractured surface, flakes appear as bright silvery areas; on an etched surface they appear as short, discontinuous cracks. Also called "shatter cracks and snowflakes."

FLASH: — (1) In forging, the excess metal forced between the upper and lower dies. (2) In die casting, the fin of metal that results from leakage between the mating die surfaces. (3) In resistance butt welding, a fin formed perpendicular to the direction of applied pressure.

FLASH LINE: — The line of location of flash formed around a forging.

FLASH POINT: — The lowest temperature at which a substance will decompose to a flammable gaseous mixture. The temperature at which the vapor air mixture first ignites is the flash point. This temperature can be determined by raising the temperature of the liquid in accordance with the pre-determined schedule, and periodically introducing a flame or other ignition means immediately above the surface.

FLAW: — An imperfection in an item or material that may or may not be harmful. See DISCONTINUITY.

FLAW SENSITIVITY (RT): — See SENSITIVITY, DEFECT.

FLUORESCENT FLUORESCENCE: — The emission of electromagnetic radiation by a substance as the result of the absorption of electromagnetic or corpuscular radiation having greater unit energy than that of the fluorescent radiation. Fluorescence is characterized by the fact that it occurs only so long as the stimulus responsible for it is maintained. The characteristic X-radiation emitted, as a result of absorption of X-rays of higher frequency is a typical example of fluorescence. Property of emitting visible light as the result of and only during, the absorption of radiant energy from some other source (i.e., UV-A).

FLUORESCENT SCREENS (RT): — Intensifying screens composed of fluorescent salts which emit a visible blue-violet electromagnetic radiation when activated by the absorption of the primary rays, thereby reducing the exposure time. See INTENSIFYING SCREEN.

FLUOROMETALLIC SCREEN (RT): — A screen consisting of a metal foil (usually lead) coated with a material that fluoresces when exposed to ionizing radiation. It combines the properties of the fluorescent and metal screen.

FLUOROSCOPY (RT): — The visual observation on a fluorescent screen of the image of an object that has been exposed to penetrating, ionizing radiation.

FLUX: — A fusible salt mixture or gas used to purify molten metal by removing suspended oxides or dissolved gas.

FLUX (NEUTRON): — The intensity of neutron radiation. It is expressed as the number of neutrons passing through 1 square centimeter in 1 second.

FLUX DENSITY (MT): — The number of magnetic flux lines per unit of area taken at right angles to the direction of magnetic field flow. This is a measure of field strength.

FLUX LINES (MT): — Also called lines of force, magnetism or induction. Imaginary lines used as means of explaining the distribution and potential of magnetic fields.

FLUX, MAGNETIC LEAKAGE: — See FIELD, LEAKAGE.

FOCAL-FILM DISTANCE (FFD) (RT): — The distance in inches between the focal spot of the X-ray tube, or gamma source, and the film.

FOCAL SPOT (RT): — The area on the target that receives the bombardment of electrons and emits the primary radiation necessary to produce an image of the object on a radiographic film. The spot at which the sound beam from a focused search unit converges to maximum intensity.

FOCUSED BEAM (UT): — Sound beam that converges to a focal spot.

FOCUSED TRANSDUCER (UT): — A transducer with a concave face which converges the acoustic beam to a focal point or line at a definite distance from the face. Also known as a focused search unit.

FOCUSING: — Concentration or convergence of energy into a small beam.

FOCUSING (RT): — Concentration or convergence of energy into a narrow beam.

FOD (RT): — Film object distance; distance from film to object being radiographed.

FOG (RT): — A general term used to denote any increase in the optical density of a processed film caused by anything other than the direct action of image-forming radiation.

FOIL: — Metal in sheet form less than 0.006 inches in thickness.

FOLD: — See LAP.

FOREIGN MATERIALS: — They may appear as isolated, irregular, or elongated variations of film density not corresponding to variations in thickness of material or to cavities. May be sand, slag, oxide or dross, or metal of different density, included in the material being examined.

FORGING: — Working metal into a desired shape by hammer, upsetting, or pressing, either hot or cold, or by a combination of these processes.

FORGING CRACKS: — See CRACKS, FORGING.

FORMING: — Making a change, with the exception of shearing or blanking, in the shape or contour of a metal part without intentionally altering the thickness.

FORWARD SCATTER: — Radiation scattered in approximately the same direction of the primary beam.

FOUNDRY: — A commercial establishment or building where metal castings are produced.

FRACTURE: — A break, rupture, or crack large enough to cause a full or partial partition of a casting.

FRAUNHOFER ZONE (UT): — See FAR FIELD.

FREQUENCY: — Frequency in uniform circular motion or in any periodic motion is the number of revolutions or cycles completed in unit time. The International System of Units expresses frequency in Hertz (1 Hz = 1 cycle per second).

FREQUENCY (FUNDAMENTAL) (UT): — In resonance testing, the frequency at which the wavelength is twice the thickness of the examined material.

FREQUENCY (INSPECTION) (UT): — Effective peak ultra-sonic wave frequency used to inspect the test part.

FREQUENCY (PULSE REPETITION) (UT): — The number of pulses per second.

FRESNEL ZONE (UT): — Pronounced "fray-NEL." See NEAR FIELD.

FRETTING (FRETTING CORROSION): — Action that results in surface damage, especially in a corrosive environment, when there is relative motion between solid surfaces in contact under pressure.

FULL-WAVE RECTIFIED SINGLE-PHASE AC: — This is rectified alternating current for which the rectifier is so connected that the reverse half of the cycle is "turned around," and fed into the circuit flowing in the same direction as the first half of the cycle. This produces pulsating D.C., but with no interval between the pulses. Such current is also referred to as single-phase full-wave D.C. It is also known as unidirectional current, single phase.

FULL-WAVE RECTIFIED THREE-PHASE AC: — When three-phase alternating current is rectified the full-wave rectification system is used. The result is D.C. with very little pulsation -in fact only a ripple of varying voltage distinguishes it from straight D.C. It is also known as unidirectional current, three phase.

FUSION: — The process by which two light nuclei combine to form a heavier nucleus.

G

GAIN: — See SENSITIVITY.

GAMMA, FILM (RT): — See GRADIENT.

GAMMA RADIOGRAPHY (RT): — The process whereby a photographic image of an object is produced by gamma radiation that has penetrated through the object.

GAMMA RADIOGRAPHY SYSTEM (RT): — All components necessary to make radiographic exposures with gamma radiation, including the exposure device, source assembly, control, and other components associated with positioning the source such as source guide tubes, exposure head, and collimators, if used.

GAMMA-RAY SOURCE (RT): — A quantity of a radionuclide that emits gamma radiation suitable for radiography.

GAMMA-RAY SOURCE CONTAINER (RT): — See CONTAINER, GAMMA-RAY SOURCE.

GAMMA RAYS: — The electromagnetic radiation of high frequency or short wavelength emitted by the nucleus of an atom during a nuclear reaction. Gamma rays are undeflected by electric or magnetic fields. They are identified in nature and properties to X-rays of the same wavelength, and differ only in their manner of production.

GAS HOLES: — Blow holes, channels, or porosity produced by gas evolution, usually during solidification.

GAS HOLES (RT) (ON RADIOGRAPH): — Appear as round or elongated, smooth-edged dark spots, occurring individually, in clusters, or distributed throughout the casting.

GAS POROSITY: — Refers to porous sections in metal that appear as round or elongated dark spots corresponding to minute voids usually distributed through the entire casting.

GAS POROSITY (RT) (ON RADIOGRAPH): — Represented by round or elongated dark spots corresponding to minute voids usually distributed through the entire casting.

GATE (UT): — Electronic device to monitor signals in a selected segment of the distance trace on an A- scan display.

GAUSS: — This is the unit of flux density or induction. The strength of field induced in a ferromagnetic body is described as being so many Gausses. It is usually designated by the letter "G." Numerically, one Gauss is one line of flux per square centimeter of area.

GEIGER-MUELLER TUBE INSTRUMENT: — A radiation detection and measuring instrument. It contains a gas-filled tube that discharges electrically when ionizing radiation passes through it. Discharges are counted to measure the radiation's intensity.

GENETIC EFFECTS OF RADIATION: — Effects that produce changes in those cells of organisms which give rise to egg or sperm cells and therefore affect offspring of the exposed individuals.

GEOMETRIC UNSHARPNESS (RT): — See UNSHARPNESS.

GHOST (UT): — An indication that has no direct relation to reflected pulses from discontinuities in the materials being tested.

GRADIENT (RT): — The slope of a characteristic curve at a specified density. Symbol: G. Note: The term "gamma" is used for the slope of the approximately straight portion of the curve.

GRAININESS (RT): — A film characteristic which consists of the grouping or clumping together of the countless small silver grains into relative large masses visible to the naked eye or with slight magnification.

GRAIN BOUNDARY: — An interface separating two grains when the orientation of the lattices changes from that of one grain to that of another. When the orientation change is very small, the boundary is sometimes referred to as subboundary.

GRAINS: — Individual alloy crystals that form the structure of the metal.

GRAIN SIZE: — Size of the crystals in metal when compared with a standard. Usually referred to as being fine, medium or coarse.

GRAIN SIZE (RT): — The average size of the silver halide particles in a photographic emulsion.

GRAY (Gy): — The SI unit of absorbed dose. One gray is equal to an absorbed dose of 1 Joule/kilogram (or 100 rads).

GRID (RT): — An assembly of strips of metal, opaque to X-rays, assembled edgewise and interleaved with material of low absorption, to be placed between the object and the screen or film, in order to reduce the effects of scattered radiation from the object.

GRINDING CRACKS: — See CRACKS, GRINDING.

GRIT BLAST: — See SANDBLAST.

H

H AND D CURVE (RT): — See CHARACTERISTIC CURVE.

HALATION (RT): — The fogging of a film emulsion due to reflection and dispersion of the radiation within the emulsion. This is generally apparent at locations of heavy exposure.

HALF-LIFE (RT): — The time in which half the atoms in a radioactive substance disintegrate. Half-lives vary from millionths of a second to billions of years.

HALF-LIFE (BIOLOGICAL): — The time required for a biological system, such as a man or an animal, to eliminate, by natural processes, half the amount of a substance that has entered it.

HALF-VALUE LAYER (RT): — The thickness of a material that transmits 50 percent of the radiation incident upon it. In exponential attenuation, the half-value layer is related to the linear attenuation coefficient and the mean free path.

HALF-WAVE RECTIFIED AC (MT): — Alternating current which passes through a rectifier in such a manner that the reversing half of the cycle (negative) is blocked out completely. It is pulsating unidirectional current. It differs from full-wave.

HALL EFFECT (MT): — The phenomenon wherein a voltage is generated across the opposite edges of an electrical conductor carrying current and placed in a magnetic field. The generated voltage differential is mutually perpendicular to the direction of current flow and the applied magnetic field.

HARDENER (RT): — An agent incorporated into the fixer solution to harden the emulsion during the fixing process. The acid hardener prevents the swelling of the emulsion and facilitates the drying process.

HARDENING: — Heating metal to within its critical range as in annealing, followed by rapid cooling as in quenching.

HARDNESS: — Resistance of metal to plastic deformation, usually by indentation. However, the term may also refer to stiffness or temper or to resistance to scratching, abrasion or cutting.

HARDNESS TESTING: — Determining hardness by means of instruments such as Brinell, Rockwell, Scleroscope, Vickers, etc.

"HARD" X-RAYS: — A term used to express the quality or penetrating power of X radiation. Hard X-rays are very penetrating.

HARMONICS (UT): — Those vibrations that are integral multiples of the fundamental frequency; used in resonance testing.

HEADS: — The clamping contacts on a stationary magnetizing unit.

H & D CURVE (HURTER AND DRIFFIELD) (RT): — See CHARACTERISTIC CURVE.

HEADSHOT (MT): — A term used colloquially to designate the magnetizing current passing through a part or a central conductor while clamped between the head contacts of a stationary magnetizing unit for the purpose of circular magnetization.

HEALTH PHYSICS: — A term in common use for that branch of radiological science dealing with the protection of personnel from harmful effects of ionizing radiation.

HEAT-AFFECTED ZONE: — That portion of the base metal which was not melted during brazing, cutting or welding, but whose microstructure and physical properties were altered by the heat.

HEAT TREAT: — Heating and cooling of a metal or alloy in the solid state for the purpose of obtaining certain desirable conditions or properties.

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HEAT TREAT CRACKS: — See CRACKS, QUENCHING.

HEAT TREATMENT: — Exposure of a metal to predetermined temperatures beyond the range of normal atmospheric conditions for a specific time to obtain a specific range of mechanical properties.

HERTZ: — One cycle per second; a unit for frequency. Abbreviation is Hz.

HETEROGENEOUS RADIATION (RT): — Radiation consisting of particles or photons that have a broad spectrum of energies.

HIGH RADIATION AREA: — Means an area, accessible to individuals, in which radiation levels could result in an individual receiving a dose equivalent in excess of 0.1 rem (1 mSv) in 1 hour at 30 centimeters from the radiation source or from any surface that the radiation penetrates.

HORIZONTAL LINEARITY (UT): — Constant relationship between the incremental horizontal displacement of vertical indications on an A-scan presentation and the incremental time required for reflected waves to pass through a known length in a uniform transmission medium.

HORSESHOE MAGNET: — A bar magnet, bent into the shape of a horseshoe so that the two poles are adjacent. Usually the term applies to a permanent magnet.

HOT CRACKS: — See CRACKS, HOT.

HOT TEAR: — A fracture formed in a metal during solidification because of hindered contraction. Usually on the surface of the part.

HOT WORKING: — Deforming metal plastically at such a temperature and rate that strain hardening does not occur. The low limit of temperature is the recrystallization temperature.

HYDROGEN EMBRITTLEMENT: — A condition of low ductility in metals resulting from the absorption of hydrogen.

HYDROMETER: — An instrument used to determine specific gravity and hence the strength. It consists of a sealed, graduated tube, weighted at one end, that sinks in a fluid to a depth used as a measure of the fluid's specific gravity.

HYDROPHILIC (PT): — Having an affinity for, attracting, adsorbing, or absorbing water. A substance soluble in water.

HYDROPHILIC REMOVER (PT): — A water compatible remover used with standard penetrants. Provides for improved control of the emulsification step process. It requires different processing steps than the standard Lipophilic emulsifiers.

HYSTERESIS (MT): — A retardation or lagging of the magnetic effect when the magnetizing forces acting upon a ferromagnetic body are changed.

I

IACS (ET): — International Annealed Copper Standard is an international standard of electrical conductivity. It is based on a high purity grade of copper designated as 100 percent.

ICICLES (BURN THROUGH): — A coalescence of metal beyond the root of the weld.

IIW BLOCK: — Specific type of reference standard used for angle beam, straight beam, and surface wave methods.

IMAGE CONTRAST (RT): — See CONTRAST, FILM.

IMAGE DEFINITION (RT): — See DEFINITION, RADIOGRAPHIC.

IMAGE INTENSIFIER (RT): — A device used in fluoroscopy to produce an image brighter than that, which would be produced by the unaided action of the X-ray beam on a fluorescent screen.

IMAGE QUALITY INDICATOR (IQI) (PENETRATOR) (RT): — A device used to determine from the appearance of its image in a radiograph, the overall quality of that radiograph. It is not intended for use in judging size nor establishing acceptance limits for discontinuities.

IMAGE QUALITY LEVEL (RT): — See RADIOGRAPHIC QUALITY LEVEL.

IMMERSION METHOD (UT): — The inspection method in which the search unit and the test part are submerged in a fluid, usually water, which acts as the coupling medium.

IMMISCIBLE (PT): — Pertaining to liquids that will not mix with each other.

IMPEDANCE: — This term is used to refer to the total opposition to the flow of current represented by the combined effect of resistance, inductance and capacitance of a circuit.

IMPEDANCE (ACOUSTIC): — Resistance to flow of ultrasonic energy in a medium. Impedance is a product of particle velocity and material density.

IMPEDANCE PLANE DIAGRAM: — A graphical representation of the locus of points indicating the variations in the impedance of a test coil as a function of basic test parameters such as electrical conductivity, magnetic permeability, test frequency, thickness and magnetic coupling.

IMPEDANCE PLANE ANALYSIS: — A term generally applied to eddy current testing which measures the overall change in impedance caused by variations in electromagnetic properties as differentiated from phase analysis testing which measures changes in phase.

IMPURITIES: — Elements or compounds whose presence in a material is undesired.

INCLUSION: — Particles of impurities, usually oxides, sulphides, silicates, and such, which are retained in the metal during solidification or which are formed by subsequent reaction of the solid metal.

INCOMPLETE FUSION: — Fusion that is less than complete. Failure of weld metal to fuse completely with the base metal or preceding bead.

INCOMPLETE PENETRATION: — Root penetration that is less than complete or failure of a root pass and a backing pass to fuse with each other.

INDENTATION: — In a spot, seam or projection weld, the depression on the exterior surface of the base metal.

INDICATION: — In nondestructive inspection, a response or evidence of a response from an inspection, that requires inter-

pretation to determine its significance.

INDICATION (MT): — This term refers to any magnetically held magnetic particle pattern on the surface of a part being tested.

INDICATION (PT): — The visible evidence of penetrant which has come out of a discontinuity, indicating to the inspector that some sort of surface opening is present.

INDICATION (UT): — The signal displayed on the ultrasonic equipment.

INDIVIDUAL MONITORING DEVICES: — Devices designed to be worn by a single individual for assessment of dose equivalents. Although they may include film badges, thermoluminescent dosimeters (TLDs), pocket ionization chambers and personal air sampling devices, their use within the Army is usually limited to TLDs.

INDUCED CURRENT MAGNETIZATION (MT): — A special technique used to establish a circular field for the detection of circumferential discontinuities in ring-shaped parts without making direct contact with the surface of the part. Sometimes referenced as Induced Field.

INDUCTANCE: — A property of a circuit that opposes any change in the existing current. Inductance is present only when the current is changing. A coil is a source of inductance.

INDUCTION: — Magnetic induction is the magnetism induced in a ferromagnetic body by some outside magnetizing force.

INDUCTIVE REACTANCE: — This is the opposition, independent of resistance, of a coil to the flow of an alternating current.

INDUSTRIAL RADIOLOGY (RT): — That branch of radiology covering industrial applications of ionizing radiation.

INGOT: — A casting suitable for working or remelting.

INHERENT DEFECTS: — Defects introduced into steel at the time it originally solidifies from the molten state.

INHERENT FILTRATION (RT): — The filtration exhibited by the walls and other materials of a radiation source through which the radiation must pass before it is utilized. Inherent filtration affects the spectral distribution of the radiation, and thus, the quality of the final radiograph.

INHIBITOR: — A substance that retards some specific chemical reaction such as rusting.

INITIAL PULSE (UT): — Electrical pulse generated by the ultrasonic instrument; used to excite a search unit in order to produce ultrasonic energy. Sometimes called the main bang.

INSPECTION: — Process of examining for possible defects or for deviation from established standards.

INTENSIFYING SCREEN (RT): — A layer of material that, when placed in contact with a photographic film, improves the efficiency of the photographic action of ionizing radiation on the film emulsion. The increased rate of absorption of radiation energy by the emulsion enables reduction of exposure time.

INTENSITY, RADIATION (RT): — The amount of energy passing per unit time per unit area at a point in a beam of radia-

tion, the area being perpendicular to the direction of propagation.

INTERACTION (RT): — Any process in which all or part of the energy of incident radiation is transferred to the electrons or nuclei of the atoms that constitute matter, or in which only the direction of the incident particle is altered.

INTERFACE: — The physical boundary between two adjacent surfaces.

INTERGRANULAR CORROSION: — Corrosion occurring preferentially at grain boundaries.

INTERLOCK (RT): — A device for precluding access to an area of radiation hazard either by preventing entry or by automatically removing the hazard.

INTERMEDIATE LAYER METHOD (ET): — A method of liftoff compensation where the same eddy current indication is obtained from bare metal and at a predetermined distance from the bare metal using a nonconductive shim (intermediate layer).

INTERNAL COIL (ET): — A coil wound upon a bobbin and having a cross-sectional configuration close to that of the internal bore or passage of the test object.

INTERNAL STRESSES: — Unseen forces existing within a part. These are forces that exist without the part being subjected to a working load.

INTERPRETATION (Evaluation): — The determination of the cause of an indication or the evaluation of the significance of discontinuities from the standpoint of whether they are detrimental defects.

INTERSTITIAL SOLID SOLUTION: — An alloy in which small atoms of alloying elements including carbon, nitrogen or hydrogen assume positions between the lattice sites normally occupied by the base metal.

INVERSE SQUARE LAW (RT): — At constant kilovoltage or source strength, the intensity of the radiation reaching the object is governed by the distance between the focal spot or radioactive source and the object, varying inversely with the square of the distance.

INVERSE VOLTAGE (RT): — A voltage that may appear across an X-ray tube or rectifier during one half-cycle of an alternating current and that reverses the polarity of the electrodes relative to the previous half-cycle.

INVESTMENT CASTING: — (1) Casting metal into a mold produced by surrounding (investing) in expendable pattern with a refractory slurry that sets at room temperature after which the wax, plastic or frozen mercury pattern is removed through the use of heat. Also called precision casting or lost-wax process. (2) A casting made by the process.

ION (RT): — An ion is an atom or group of atoms that is not electrically neutral but instead carries a positive or negative electric charge. Positive ions are formed when neutral atoms or molecules lose valence electrons; negative ions are those which have gained electrons.

ION PAIR (RT): — A positive ion and a negative ion or electron having charges of the same magnitude, and formed simultaneously from a neutral atom or molecule with energy supplied by radiation or any other suitable source.

IONIC (RT, PT): — Relating to, existing in the form of, or characterized by ions.

IONIZATION: — The process of adding electrons to, or knocking electrons from, atoms or molecules, thereby creating ions.

High temperatures, electrical discharges, and nuclear radiation can cause ionization.

IONIZATION CHAMBER: — An instrument that detects and measures ionizing radiation by observing the electrical current created when radiation ionizes gas in the chamber, making it a conductor of electricity.

IONIZING RADIATION: — Any radiation that directly or indirectly displaces electrons from the outer domains of atoms. Examples: alpha, beta, and gamma radiation.

IQI SENSITIVITY (RT): — The sensitivity (quality level) of a radiographic process, as determined by the use of an image quality indicator (IQI). Properly called radiographic sensitivity.

IRIDIUM-192: — A radioactive isotope of the element Iridium that has a half life of 75 days. It is used extensively as a source of gamma radiation.

IRRADIATION: — Exposure to radiation, as in a nuclear reactor.

ISOMER (RT): — One of two or more nuclides that are both isotopes (same atomic number) and isobars (same mass number) of each other, but which have some measurably different physical property, such as half life.

ISOMERIC TRANSITION (RT): — The transition of an isomer to a lower energy state. It is accompanied by the emission of gamma radiation that may be internally converted.

ISOTOPE (RT): — One of several nuclides having the same number of protons in their nuclei, and hence belonging to the same element, but differing in the number of neutrons, and therefore in mass number. Small quantitative differences in chemical properties exist between elements and isotopes. Isotopes may or may not be unstable. Unstable isotopes undergo transitions to other isotopes or elements with a loss of energy. Such energy is usually given off in the form of electromagnetic or particle radiation. Isotopes are used as source of radiation for radiography.

K

KEY SWITCH (RT): — A device that requires a key for making and breaking electrical connections.

KILOHERTZ: — Unit of frequency equal to 1,000 Hz. Abbreviation is kHz.

KILOVOLT: — Unit of electromotive force or potential equal to 1,000 volts.

L

LACK OF FUSION: — Two-dimensional defect due to lack of union between weld metal and parent metal..A casting made in a mold (sand, plaster, or permanent mold) which rotates while the metal solidifies under the pressure developed by centrifugal force.

LAMB WAVE (UT): — A complex type of ultrasonic wave propagated in metal sheets up to a few wavelengths thick. Their propagation characteristics are dependent upon the properties of the material and its thickness, along with the frequency of the incident wave. These vibrations occur throughout the thickness of the material and consist of two basic types, symmetrical and asymmetrical. Each of these types may have an infinite number of modes, which are determined, by the wave's incident angle. They can be very effective for detecting laminar discontinuities, but, because of their complexity, practical application can be difficult.

LAMBDA (λ): — Symbol for wavelength; the eleventh letter of the Greek alphabet.

LAMINATE: — (1) A composite metal, usually in the form of sheet or bar, composed of two or more metal layers so bonded that the composite metal forms a structural member. (2) To form a metallic product of two or more bonded layers.

LAMINATIONS: — Discontinuities in plate, sheet or strip caused by pipe, inclusions, or blowholes in the original ingot; after rolling they are usually flat and parallel to the outside surface.

LAP: — A surface defect, appearing as a seam, caused by folding over hot metal, fins or sharp corners and then rolling or forging them into the surface, but not welding them.

LATENT IMAGE (RT): — The metallic silver image of the material radiographed brought out by the developing process.

LATITUDE (RT): — Latitude, most closely aligned with contrast, is the range of thickness that can be transferred or recorded on a radiograph within the useful reading range of film density. A high contrast has little latitude whereas a low contrast film will have great latitude.

LATITUDE, THICKNESS (RT): — The range of thickness of a specified material that corresponds to the range of useful film densities.

LATTICE: — The repetitive three-dimensional arrangement of atoms in a solid.

LEAD EQUIVALENT (RT): — The thickness of lead affording the same attenuation of radiation under specified conditions, as the material in question.

LEAD SCREENS: — See SCREENS, LEAD.

LEAK: — A hole or void in the wall of an enclosure, capable of passing liquid or gas from one side to the other under action of a pressure or concentration difference existing across the wall.

LEAKAGE (RT): — The undesired release of radioactive material from a sealed source.

LEAKAGE FIELD: — See FIELD, LEAKAGE.

LEAKAGE RADIATION (RT): — Radiation other than the useful beam emitted from an X-ray tube assembly or source housing.

LEAK TEST (RT): — A method capable of detecting the leakage of radioactive material from a sealed source.

LEAK TESTING (PT): — Method of applying penetrant to one surface and developer to the opposite side of a structure to detect flaws that extend entirely through the structure.

LENGTH/DIAMETER RATIO (MT): — A ratio of the length and diameter of a part for the purpose of calculating the amperes required for longitudinal magnetization.

LICENSED MATERIAL (RT): — Source material, special nuclear material, or byproduct material received, possessed, used, or transferred under a general or special license issued by the Nuclear Regulatory Commission or an Agreement State.

LIFT-OFF (ET): — A measure of the gap between the face of a surface probe and the surface being inspected. It is a measure of the coupling between the probe and the material being inspected.

LIFT-OFF COMPENSATION (LIFT-OFF ADJUSTMENT) (ET): — Procedures for instrument adjustments whereby impedance variations caused by a variable gap between an eddy current surface and the test part are suppressed. This adjustment is designed to provide a better signal-to-noise ratio for eddy current inspection.

LIFT-OFF EFFECT (ET): — The effect observed in the test system output due to a change in magnetic coupling between a test specimen and a probe coil whenever the distance of separation between them is varied.

LIGHT METAL: — One of the low-density metals such as aluminum, magnesium, titanium, beryllium or their alloys.

LIGHT METER (MT, PT): — A device used to measure the light intensity of a UV-A lamp in foot candles or micro-watts per square centimeter, whichever is appropriate.

LIMIT FREQUENCY: — A mathematically derived frequency value used to establish impedance diagrams.

LINEAR ACCELERATOR: — An apparatus used to accelerate electrons to high velocities by means of a high frequency electrical wave traveling along a tube in the linear direction of the electron beam.

LINEAR INDICATIONS: — An indication having length three or more times its width.

LINEARITY (UT): — See VERTICAL LINEARITY and HORIZONTAL LINEARITY.

LINES OF FORCE (MT): — Imaginary lines used to visualize the magnetic field.

LIMITS (dose limits): — The permissible upper bounds of radiation doses.

LIPOPHILIC EMULSIFIER (PT): — An oil based liquid used in penetrant inspection to make penetrant oil water-washable.

LIQUID VEHICLE (MT): — The liquid in which the magnetic particles are suspended to facilitate their application.

LONGITUDINAL MAGNETIZATION (MT): — Magnetization of a material in such a way that the magnetic lines of force are essentially parallel to the test parts longitudinal axis.

LONGITUDINAL WAVE (UT): — A type of wave in which the particle motion of the material is essentially in the same direction as the wave propagation.

LOSS OF BACK REFLECTION (UT): — Absence of an indication of the far surface of the article being inspected.

LUMEN (PT, MT): — A measure of the brightness of light. A unit of luminous flux equal to the light emitted in a unit solid angle by uniform point source of one candela.

LUMINESCENCE (RT): — A phenomenon in which the absorption of radiation by a substance gives rise to the emission of light characteristic of the substance.

M

MACHINED SURFACE: — The metal surface left by the cutting tool.

MACHINING: — Removing material, in the form of chips, from work, usually through the use of a machine.

MACROPOROSITY (PT): — Voids or gas pockets in metals that are large enough to be seen at magnification of less than 10 diameters.

MACROSTRUCTURES: — The structure of metals, as revealed by the eye or at a magnification of less than 10 diameters.

MAGNET: — Materials that show the power to attract iron and other substances to themselves, and that exhibit polarity, are called magnets.

MAGNET, PERMANENT: — A highly retentive metal that has been strongly magnetized; for example, the alloy Alnico.

MAGNETIC COUPLING (MT): — A term designating the interaction of a magnetic field with an adjoining test part.

MAGNETIC FIELD (MT): — The space around a source of magnetic flux in which the effects of magnetism can be determined.

MAGNETIC FIELD STRENGTH (MT): — The intensity of the magnetic field surrounding the magnetized part measured in GAUSS.

MAGNETIC FLUX: — The total number of magnetic lines existing in a magnetic circuit.

MAGNETIC FORCE: — In magnetic particle inspection the magnetizing force is considered to be the total force tending to set up a flux in a magnetic circuit. It is usually designated by letter "H."

MAGNETIC HYSTERESIS: — See HYSTERESIS.

MAGNETIC LOOP: — If a conductor carrying an electric current is bent in a loop, the magnetic lines of force enter on one side of the loop and leave at the other, and the space within the loop is found to contain a magnetic field which has very definite directional properties. Polarity is created within the coil with one end being a north pole and the opposite end a south pole. The space enclosed by the loop is longitudinally magnetized. See also COIL.

MAGNETIC MATERIALS: — Materials are affected by magnets in two general ways. Some of them are attracted by a magnetic force, while others exert a repellent force. The first is called "paramagnetic" and the latter "diamagnetic." In magnetic particle inspection we are not ordinarily concerned with either of the two classes, but with what may be termed a subdivision of the first class called "ferromagnetic materials."

MAGNETIC PARTICLE INSPECTION (MT): — A method for detecting discontinuities on or near the surface in suitably magnetized materials, which employ finely divided magnetic particles that tend to congregate in regions of the magnetic non-uniformity, i.e., along cracks, over inclusions, voids, etc.

MAGNETIC PERMEABILITY (MT): — A term indicating the ease with which a magnetic field can be established in a material. It is determined by the ratio of the strength of the resultant magnetic force to the applied magnetic force.

MAGNETIC POLES: — The ability of a magnet to attract or repel is not uniform over its surface, but is concentrated at local areas called "poles." Each magnet has at least two poles, one of which is attracted by the earth's North Pole and is called the north pole of the magnet, and the other which is attracted by the earth's South Pole and is called the south pole of the magnet. Magnetic leakage occurs at poles.

MAGNETICALLY HARD ALLOY: — A ferromagnetic alloy capable of being magnetized permanently because of its ability to retain induced magnetization and magnetic poles after removal of externally applied fields; an alloy with high coercive force. The name is based on the fact that the quality of the early permanent magnets was related to their hardness.

MAGNETICALLY SOFT ALLOY: — A ferromagnetic alloy that becomes magnetized readily upon application of a field and that returns to practically a nonmagnetic condition when the field is removed; an alloy with the properties of high magnetic permeability, low coercive force and low magnetic hysteresis loss.

MAGNETIC RUBBER INSPECTION (MT): — An inspection process involving the use of a formulation of magnetic particles dispersed in a room temperature curing rubber. An extension of the magnetic particle method used for detection of flaws in problem areas such as bolt holes, tubes, etc.

MAGNETIC SATURATION (MT): — The degree of magnetization when increasing the magnetizing force upon a part no longer increases the magnetic flux density (permeability) in the part.

MAGNETIC WRITING (MT): — A form of nonrelevant indications, sometimes caused when the surface of a magnetized part comes into contact with another piece of ferromagnetic material.

MAGNETISM (MT): — The ability of matter to attract other matter to itself and exhibit polarity.

MAGNETIZING CURRENT (MT): — The flow of either alternating, rectified AC or direct current used to induce magnetism into the part.

MAGNETIZING FORCE: — For the purpose of this discussion, magnetizing force is considered to be the total force tending to set up a magnetic flux in a magnetic circuit. It is usually designated by the letter "H" and the unit is the "Oersted."

MAIN BANG (UT): — See INITIAL PULSE.

MAINTENANCE INSPECTION: — Inspecting any tooling, machines, or equipment periodically, or during rebuilding to prevent future in-service failure.

MAP: — Locating the boundaries of a discontinuity.

MAS: — Milliampere seconds, utilized to standardize radiographic exposures. Example: 5 MA X 60 seconds = 300 MAS.

MASKS OR MASKING (RT): — Surrounding specimens or covering thin sections with absorptive material to eliminate scatter and halation on the film image.

MASS NUMBER: — The sum of the neutrons and protons in a nucleus. The mass number of uranium-235 is 235. It is the nearest whole number to the atom's actual atomic weight.

MATERIAL NOISE: — Extraneous signals caused by the structure of the material being tested.

MAXIMUM PERMISSIBLE DOSE (MPD): — That dose of ionizing radiation which competent authorities have estab-

lished as the maximum that can be absorbed without undue risk to human health.

MECHANICAL PROPERTIES: — The properties of a material that reveal its elastic and in-elastic behavior where force is applied, thereby indicating its suitability for mechanical applications; for example, modulus of elasticity, tensile strength, elongation, hardness, and fatigue limit.

MEGAHERTZ: — Unit of frequency equal to one million Hertz. Abbreviation is MHz. See also FREQUENCY.

METALLOGRAPH: — An optical instrument designed for both visual observation and photomicrography of prepared surfaces of opaque materials at magnifications ranging from about 25 to about 1500 diameters.

METALLOGRAPHY: — The science dealing with the constitution and structure of metals and alloys as revealed by the unaided eye or by such tools as low-powered magnification, optical microscope, electron microscope and diffraction or X-ray techniques.

METALLURGY: — The science and technology of metals.

MeV: — One million electron volts.

MICRO: — A prefix that divides a basic unit by one million.

MICROGRAPH: — A graphic reproduction of the surface of a prepared specimen, usually etched, at a magnification greater than ten diameters. If produced by photographic means it is called a photomicrograph (not a microphotograph).

MICROPOROSITY: — Porosity visible only with the aid of a microscope.

MICROSECOND: — Unit of the time equivalent to 10^{-6} second or 0.000001 second.

MICROSTRUCTURE: — The structure of polished and etched metals as revealed by a microscope at a magnification greater than ten diameters.

MILLI: — A prefix that divides a basic unit by one thousand.

MILLIAMPERAGE (RT): — Milliamperage is a measure of the current flowing between the cathode and the anode in an X-ray tube, and is a measure of the intensity of the emitted radiation.

MILLIAMPERE (RT): — A unit of electrical current equal to one thousandth of an ampere.

MILLIAMPERE-SECONDS (RT): — A term used to quantify radiographic exposures made with X-rays. It is the product of tube current in milliamperes and exposure time in seconds. Abbreviation: mAs.

MILLIROENTGEN (mR): — One-thousandth of a roentgen.

MINIATURE ANGLE BEAM BLOCK (UT): — Specific type of reference standard primarily used for the angle beam method, but also used for the straight beam and surface wave methods.

MISCIBLE (PT): — The tendency of capacity of two or more liquids to form a uniform blend, that is, to dissolve in each

other; degrees are total miscibility, partial miscibility, and immiscibility.

MISRUN: — A casting not fully formed due to metal failing to fill the mold.

MISRUNS (RADIOGRAPHIC): — Appears as prominent darkened areas of variable dimensions with a definite smooth outlines.

MOBILITY (MT): — The ease with which magnetic particles move over the surface of a magnetized part and accumulate at a discontinuity exhibiting polarity.

MODE: — The manner in which acoustic energy is propagated through a material as characterized by the particle motion of the wave.

MODE CONVERSION (UT): — Changing from one mode of vibration to another; caused by refraction at an interface.

MODE OF VIBRATION (UT): — Type of wave motion; e.g., longitudinal, transverse, etc. Three common modes of vibration used in ultrasonic inspection are longitudinal, transverse, and surface wave modes.

MODULATION ANALYSIS (ET): — An instrumentation method used in eddy current testing which separates responses based on their frequency or rate of response. For instance, slow responses from gradual dimension changes can be separated from rapid responses from a crack.

MOLD: — A form or cavity into which molten metal is poured to produce a desired shape. Molds may be made of sand, plaster or metal and frequently require the use of cores and inserts for special applications.

MOLECULE: — The smallest unit quantity of matter that can exist by itself and retain all the properties of the original substance. Molecules are formed by the chemical combination of atoms.

MONITORING (RT): — Periodic or continuous determination of the amount of ionizing radiation or radioactive contamination present in an occupied region.

MONOCHROMATIC: — (Homogeneous) of the same wavelength.

MOTTILING (RT): — Large graininess effect on a radiograph that may be due to diffraction by large grain structures in materials, or can be caused by the use of fluorescent screens. Mottling is readily distinguishable from film graininess because of its coarse appearance and lack of definition.

MT: — Symbol for the magnetic particle method of nondestructive testing/inspection.

MULTIDIRECTIONAL MAGNETIZATION: — Two separate fields, having different directions, cannot exist in a part at the same time. But two or more fields in different directions can be imposed upon a part sequentially in rapid succession. When this is done magnetic particle indications are formed when discontinuities are located favorably with respect to the directions of each of the fields, and will persist as long as the rapid alternations of field direction continue. This, in effect, does constitute two or more fields in different directions at the same time, and enables the detection of defect oriented in any direction in one operation.

MULTIPLE REFLECTIONS (UT): — Successive echoes of ultrasonic energy between two surfaces.

N

NANOMETER: — A unit of length equal to one billionth of a meter, or 10^{-9} meter. The Nanometer has replaced the angstrom unit as a measurement of short wave length, electromagnetic radiation where 1 nm = 10 angstroms.

NANOSECOND: — (10^{-9}) one billionth of a second.

NARROW-BAND (UT): — Having a relatively narrow bandwidth; opposite of broad-banded; see TUNED.

NEAR FIELD (UT): — The region of the ultrasonic beam adjacent to the search unit, having complex beam profiles; also known as the Fresnel zone. The length of the near field extends from the face of the search unit to the point at which the far field begins and is given by the equation: $N = D^2f/4v$

where:

N = near field length - inches.

D = the major dimensions of the search unit element - inches.

For circles, D = the diameter. For rectangles or squares,

D = diagonal. f = ultrasonic frequency - hertz

v = ultrasonic velocity - inches per second.

NEUTRON: — An uncharged elementary particle with a mass nearly equal to that of the proton. The isolated neutron is unstable and decays with a half-life of about 13 minutes into an electron, proton, and neutrino. Neutrons sustain the fission chain reaction in a nuclear reactor. Neutron radiograph is a technique in which neutrons are used as a penetrating radiation to produce a radiograph.

NEUTRON RADIOGRAPHY (RT): — The process whereby a photographic image of an object is produced by neutron radiation that has penetrated through the object.

NODE: — A point in a standing wave where some characteristic of the wave field has essentially zero amplitude.

NOISE (UT, ET): — Any undesired signal that tends to interfere with normal reception or processing of the desired signal. Origin may be electrical or from material structure.

NONAQUEOUS DEVELOPER: — See SOLVENT DEVELOPER.

NONDESTRUCTIVE INSPECTION (NDI): — A method used to check the soundness of a material or a part without impairing or destroying the serviceability of the part.

NONFERROMAGNETIC MATERIAL (NONMAGNETIC): — A material that is not magnetizable and hence, essentially not affected by magnetic fields. This would include paramagnetic materials having a magnetic permeability slightly greater than that of a vacuum and approximately independent of the magnetizing force and diamagnetic materials having permeability less than a vacuum. Some metals free from iron are zinc, tin, aluminum, brass, copper and pot metal.

NON-METALLIC INCLUSION: — Inclusions are generally oxide or sulfide impurities in the metal. They may be stretched out and broken up during rolling or forging.

NON-RELEVANT INDICATIONS: — An indication due to misapplied or improper inspection. Also, an indication caused by an actual discontinuity in the material or material condition that does not affect the usefulness of the part (such as a change of section).

NON-SCREEN FILM (RT): — X-ray film designed for use with or without metal screens, but not intended for use with salt

screens. It may be of relatively high speed and coarse grain (ordinary non-screen film) or of lower speed and finer grain (fine grain non-screen film).

NOTCH SENSITIVITY: — A measure of the reduction in strength of a metal caused by the presence of stress concentration. Values can be obtained from static, impact or fatigue tests.

NUCLEAR REACTION: — A reaction involving an atom's nucleus, such as fission, neutron capture, radioactive decay, or fusion, as distinct from a chemical reaction, which is limited to changes in the electron structure surrounding the nucleus.

NUCLEAR REACTOR: — A device by means of which a fission chain reaction can be initiated, maintained, and controlled. Its essential component is a core with fissionable fuel. It usually has a moderator, a reflector, shielding, and control mechanisms.

NUCLEAR TRANSITION (RT): — A change in the energy state or level of an atomic nucleus which may, or may not, result in the emission of radiation.

NUCLEUS: — The heavy central part of an atom in which most of the mass and the total positive electric charge is concentrated. With the exception of the nucleus of hydrogen, nuclei are composed of protons and neutrons. The charge of the nucleus, an integral multiple of the charge of the electron, is the essential factor that distinguishes one element from another chemically.

NUCLIDE (RT): — Any species of atom characterized by its mass number, atomic number, and nuclear energy state, and that has a measurable mean life. The term is used synonymously with isotope. A radionuclide is a radioactive nuclide.

O

OBJECT-TO-FILM DISTANCE (RT): — The distance from the tube or source side of the irradiated specimen to the film surface, i.e., inclusive of specimen thickness. Abbreviation: ofd.

OCCUPANCY FACTOR (RT): — The factor by which the workload should be multiplied to correct for the degree or type of occupancy of the area in question. Symbol: T.

OCCUPATIONAL DOSE: — The dose received by an individual in a restricted area or in the course of employment in which the individual's assigned duties involve exposure to radiation. Occupational dose does not include dose received from background radiation, as a patient from medical practices, from voluntary participation in medical research programs, or a member of the general public.

OERSTED (MT): — A unit of field strength that produces magnetic induction designated by the letter "H." The Oersted is numerically equal in air or in a vacuum. Oersted (H) refers to the magnetizing force tending to magnetize an unmagnetized body, and Gauss refers to the field (B) so induced in the body.

OHM: — The ohm is the unit of electrical resistance. It is the value of a resistance that will pass one ampere of current at a potential of one volt.

OIL-COOLED TUBE (RT): — An X-ray tube in which the heat produced is dissipated, directly or indirectly, by means of oil.

OPTICAL DENSITY (RT): — See DENSITY.

OPTIMUM FREQUENCY (ET, UT): — That frequency, which provides the highest signal-to-noise ratio obtainable for the

detection of an individual property such as conductivity, crack, or inclusion of the test specimen. Each type of defect in a given material may have its own optimum frequency.

ORBITAL ELECTRON (SHELL ELECTRON) (RT): — An electron in the extra-nuclear structure of an atom.

ORIENTATION: — Position of a discontinuity or part or surface in relation to the test surface of the article or ultrasonic beam.

ORIENTATION (CRYSTAL): — Arrangement in space of the axes of a crystal with respect to a chosen reference or coordinate system.

OSCILLATOR (ET): — A component of an electrical circuit that provides a source of current that varies in magnitude and direction with time. In eddy current testing, the oscillator provides a source of alternating current.

OVER-DEVELOPMENT (RT): — Development that is greater than that required to produce the optimum results in a particular radiograph. It may arise from development for too long a time, or at too high a temperature, and may give rise to excessive graininess and lack of contrast.

OVERHEATED: — Steel subjected to such high temperatures that coarse grains are produced without destroying the stock as in burning. This may be corrected by suitable heat treat.

OVERLAP: — Protrusion of weld metal beyond the bond at the toe of the weld.

OVERSTRESSING: — Subjecting a part or item to loads or stresses beyond design limits.

OXIDATION: — The reaction of an element to oxygen or an oxygen containing compound.

OXIDATION FOG (RT): — Fog caused by exposure of a film to air during development.

P

PAIR PRODUCTION (RT): — The conversion of very high-energy photons, when absorbed in matter, by a process wherein the photon is converted in the electrical field of a nucleus into an electron (negative charge) and a positron (equal but opposite positive charge).

PARALLEL INDUCED MAGNETIC FIELD: — A magnetic field induced in a piece of magnetizable material that is placed parallel to a conductor carrying an electric current.

PARAMAGNETIC (MT): — Materials in which the magnetic permeability is slightly greater than one. These materials are classified as nonmagnetic with a permeability of one for purposes of eddy current inspection. A material which can be slightly magnetized, but not sufficiently to permit magnetic particle inspection.

PART: — A term used to refer to a manufactured article that is being inspected.

PARTICLE: — A minute constituent of matter with a mass and charge.

PARTICLE MOTION (UT): — Movement of particles in an article brought about by the action of a transducer.

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PASTE (MAGNETIC): — Finely divided, ferromagnetic particles in paste form used in preparing wet suspensions magnetic particle inspection.

PEAK VOLTAGE (RT): — The maximum value achieved by a varying voltage.

PENETRAMETER (RT): — A device employed to obtain evidence on a radiograph that the technique used was satisfactory. It is not intended for use in judging the size of discontinuities nor for establishing acceptance limits for materials or products.

PENETRAMETER SENSITIVITY (RT): — See SENSITIVITY, RADIOGRAPHIC.

PENETRANT (PT): — A liquid of high surface tension and high capillary action which is a vehicle for a colored or a fluorescent dye, used to penetrate into the defect and detect surface discontinuities.

PENETRANT DWELL (PT): — The period of time wherein parts are immersed in a bath of liquid penetrant, plus the time the liquid penetrant remains on the surface of the part.

PENETRANT INDICATION: — Readings that mark or denote the presence of material defects.

PENETRANT, POST EMULSIFIABLE (PT): — A penetrant that requires the application of a separate emulsifier to render the surface penetrant water-washable.

PENETRANT REMOVER (PT): — A penetrant remover is a solvent-type liquid used to clean penetrants from the surface of a material.

PENETRANT SENSITIVITY (PT): — Penetrant sensitivity is the ability of the penetrant, processing technique, and developer to detect surface-connected discontinuities and provide an indication visible to the unaided eye.

PENETRANT, VISIBLE (PT): — A penetrant that is characterized by an intense visible color, usually red, that allows it to give contrasting indications on a white developer background.

PENETRANT, WATER- WASHABLE (PT): — See WATER-WASHABLE.

PENETRATION: — The maximum depth from which indications can be measured in a material.

PENETRATION (RT): — A qualitative term used to describe the degree to which radiation is capable of penetrating a given object. Penetration is usually a function of the applied tube voltage in X-rays or equivalent voltage in isotope radiography.

PENUMBRA (RT): — The shadow cast when the incident radiation is partly, but not wholly, cut off by an intervening body; the space of partial illumination between the umbra, or perfect shadow, on all sides and the full light. A marginal region of borderland of partial obscurity.

PERIODIC TABLE: — A tabular arrangement of elements according to their properties.

PERMEABILITY (MT): — The ease with which a magnetic field or flux can be set up in a magnetic circuit. It is not a constant value for a given material, but is a ratio. At any given value of magnetizing force, permeability is B/H the ratio of flux density, B , to magnetizing force H .

PERMANENT MAGNETS: — A body that possesses the ability to retain or hold a large amount of the applied magnet field after the active power of the field is removed.

PERSONNEL MONITORING EQUIPMENT (RT): — Devices designed to be worn or carried by an individual for the purpose of measuring the dose received (e.g., film badges, pocket chambers, pocket dosimeters, film rings, etc.)

PHASE: — In periodic changes of any magnitude varying according to a simple harmonic law (as ultrasonic vibrations, alternating electric currents, etc.), the point or stage in the period to which the variation has advanced, considered in its relation to a standard position; can be expressed in degrees.

PHASE ANALYSIS: — An instrumentation technique which discriminates between variables in the test part by the different phase angle changes which these conditions produce in the test signal.

PHASE ANGLE: — The angular equivalent of the time displacement between corresponding points on two sine waves of the same frequency.

PHASE SHIFT: — A change in the phase relationship between two alternating quantities of the same frequency.

PHOTOELECTRIC ABSORPTION (RT): — A process by which electromagnetic radiation imparts energy to matter.

PHOTOGRAPHIC EMULSION (RT): — See EMULSION.

PHOTON (RT): — An electromagnetic packet of radiation. It has a dual character, acting sometimes like a particle and at other times like a wave. Photons all have equal velocity (the speed of light), have no electric charge, and have no mass.

PHOTOTHERMO-GRAPHIC FILM (RT): — A blue/green sensitive "dry silver" film used in conjunction with special fluorescent screens in vacuum cassettes which can serve as an alternative to X-ray film for noncritical applications. The principle advantage of this film is that it is processed thermally, eliminating the need for wet chemicals.

PHYSICAL PROPERTIES: — The properties, other than mechanical properties, that pertain to the physics of a material; for example, density, electrical conductivity, heat conductivity, thermal expansion.

PHYSICAL TESTING: — Determination of Physical Properties.

PICKLE: — Using acid or other chemicals with suitable inhibitors to remove scale or smeared metal without affecting the sound metal.

PICKLING CRACKS: — Cracks cause by the release of internal stresses due to metal removal by immersion in acid or chemical solutions.

PIEZOELECTRIC (UT): — That ability of a material to convert electrical energy into mechanical energy and vice versa.

PINHOLE (RT): — A through hole of small diameter in a sheet of material opaque to radiation.

PIPE: — (1) The central cavity formed by contraction in metal, especially ingots, during solidification. (2) The defect in wrought or cast products resulting from such a cavity. (3) An Extrusion Defect due to the oxidized surface of the billet flowing toward the center of the rod at the back end. (4) A tubular metal product, cast or wrought.

PITCH-CATCH (UT): — Used to describe an inspection method in which the ultrasonic energy is emitted by one transducer element and received by another on the same or adjacent surface.

PITTING: — Forming small sharp cavities in a metal surface by nonuniform electrodeposition or by corrosion.

PIXEL BRIGHTNESS (RT/CR): — The luminous (monitor) display intensity of pixel(s) that can be controlled by means of electronic monitor brightness level settings or changes of digital driving level.

PIXEL DENSITY (RT/CR): — The number of pixels within a digital image of fixed dimensions (that is, length and width).

PIXEL VALUE(RT/CR): — A positive integer numerical value directly associated with each binary picture data element (pixel) of an original digital image where gray scale shades are assigned in linear proportion to radiation exposure dose received by that area.

PLANCK'S CONSTANT (RT): — A fundamental physical constant; the ratio of the energy of a photon to its frequency.

PLASTIC DEFORMATION: — Working of a material beyond its elastic limit to produce a permanent change in dimensions.

PLATING: — Forming an adherent layer of metal upon an object.

PLATE WAVE: — See LAMB WAVE.

POINT OF INCIDENCE (UT): — Designates the point at which the center of the sound beam leaves the wedge from an angle beam search unit.

POLARITY: — The quality of having two opposite magnetic poles, one north and one south.

POLE (MT): — The area on a magnetized part from which the magnetic field leaves or enters the part.

POROSITY: — Random pits or holes in the object.

POSITRON: — A fundamental particle of nature having a mass equal to that of the electron and possessing a positive charge equal to the negative charge of the electron. The mass of the positron is therefore 9.107×10^{-28} gm; the electrical charge carried by the positron is equal to 4.802×10^{-10} statcoulomb (electrostatic unit of charge).

POST-CLEANING (PT): — The removal of residual penetrant and/or developer from the item after the inspection operation.

POST-EMULSIFICATION (PT): — The technique wherein a separate emulsifying step is required to facilitate water rinse removal of the surface penetrant.

POTTER-BUCKY DIAPHRAGM (RT): — A device incorporating an anti-scatter grid that is kept in motion during the time of a radiographic exposure so as to avoid grid images on the radiograph.

POTTER-BUCKY GRID (RT): — See POTTER-BUCKY DIAPHRAGM.

POWDER, DRY (MT): — Finely divided ferromagnetic particles suitably selected and prepared for magnetic particle inspection.

PRECIPITATE (MT): — The separating of the magnetic particles from the liquid vehicle. Used primarily for checking concentration of magnetic particles in the vehicle.

PRECIPITATION HARDENING: — The process by which a metal is hardened by the formation of small particles of secondary composition from a solid solution. This process is usually performed at an elevated temperature considerably below the temperature of solution heat treating.

PRECIPITATION HEAT TREATMENT: — Artificial aging in which a constituent precipitates from a supersaturated solid solution.

PRE-CLEANING: — The cleaning of a part before testing so that it is free from all foreign material (paint, grease, oil, rust, scale, layout dye, wax crayon markings, etc.) which may cover a surface discontinuity and thereby inhibit the entrance of the penetrant liquid, or absorb the penetrant and render an "irrelevant indication."

PRESENTATION (UT): — The method used to show ultrasonic wave information. May include A, B, or C scans displayed either on various types of recorders or cathode ray instrumentation's.

PRESERVATIVE, DEVELOPER (RT): — A constituent (e.g., sodium sulfate) that minimizes the exhaustion of a developer caused by aerial oxidation, and serves to remove oxidation products which might retard development or produce stain.

PRESSURE MARK (RT): — An effect produced by pressure on a film which after developing results in areas of either increased or decreased density. The crescent-shaped pressure mark due to severe local bending of a film is often called a crimp mark.

PRIMARY MAGNETIC FIELD (ET): — In eddy current inspection, the field produced by the test coil or coils as differentiated from the magnetic field produced by the eddy current or the resultant field.

PRIMARY RADIATION (RT): — Radiation coming directly from the source of radiation that has undergone no physical process changing its character.

PROBE (ET, MT, UT): — An assembly containing a small coil or coils designed for eddy current inspection of small areas immediately adjacent to the coil and an electromagnet producing magnetic fields for magnetic inspection. The unit has two jointed laminated pole pieces permitting adjustment to varying surfaces configuration. Also the device contains a microphone used with an ultrasonic leak detector to receive ultrasonic energy resulting from leakage. See SEARCH UNIT.

PROBE WOBBLE (ET): — The change in angular orientation between a surface probe and the inspection surface. Probe wobble results in lift-off variations.

PROCESS CONTROL: — Is a general term used to encompass the actions and documentation, as required by official directives or logic, that are necessary for a NDI method to be effective in detecting conditions of interest (e.g., cracks, foreign objects, corrosion, alignment of parts, thickness of parts/coating and pressure/vacuum leaks).

PROCESSING, FILM (RT): — A series of operations, such as developing, fixing, and washing, associated with the conversion of a latent image into a stable visible image.

PRODS (MT): — Hand held electrodes attached to cables to transmit the magnetizing current from the source to the part being inspected.

PROPAGATION: — Advancement of a wave through a medium.

PROTECTIVE MATERIAL (RT): — Shielding material used for the purpose of radiation protection.

PROTON: — An elementary particle with a single positive electrical charge and a mass approximately 1847 times that of the electron. The atomic number of an atom is equal to the number of protons in its nucleus.

PSIG: — Pounds per square inch; gauged air pressure gauged by a regulator.

PT: — Symbol for the liquid penetrant method of nondestructive testing/inspection.

PULSE (UT): — A series of vibrations or oscillations having a brief duration.

PULSE-ECHO METHOD (UT): — An inspection method in which the presence and position of a discontinuity is indicated by the echo amplitude and time position; also designates a method of inspecting bonded honeycomb structures by monitoring the echoes from the far side of the core.

PULSE LENGTH (UT): — A measure of the duration of a pulse, expressed in time or number of cycles.

PULSE REPETITION RATE (UT): — See FREQUENCY, PULSE REPETITION.

Q

QUALITY FACTOR (RT): — The linear-energy-transfer-dependent factor by which absorbed doses are to be multiplied to obtain, for radiation protection purposes, a quantity (i.e., dose equivalent) that expresses on a common scale for all ionizing radiation the irradiation incurred by exposed persons. The quality factor weights the absorbed dose for the biological effectiveness of the particular type of radiation producing the absorbed dose. Symbol: Q.

QUALITY LEVEL (RT): — See RADIOGRAPHIC QUALITY LEVEL.

QUANTUM: — If the magnitude of a quantity is always an integral multiple of a definite unit, then that unit is called the quantum of the quantity. The photon is a quantum of the electromagnetic field and the meson is considered to be the quantum of the nuclear field.

QUANTUM (RT): — A discrete amount of radiation energy. The quantum energy is $E=hu$, where u is the frequency of the radiation and h is Planck's constant.

QUENCH CRACKS: — See CRACKS, QUENCHING.

QUENCHING: — Rapid cooling. When applicable, the following more specific terms should be used: direct quenching, fog quenching, hot quenching, interrupted quenching, selective quenching, spray quenching, and time quenching.

QUICK-BREAK: — Sometimes called "FAST BREAK." The sudden breaking of a direct current causes a transient current to be induced in the part by the rapid collapse of the magnetic field. In magnetic particle testing, fast breaking of the magnetizing current is used to generate a transient current in a part which is favorable for finding transverse defects at the ends of longitudinally magnetized bars. Such defects are often concealed by the strong polarity at the bar ends. At such locations the lines of force of the longitudinal field are leaving the bar in a direction normal to the surface, which prevents them from intercepting transverse defects in those areas. The field induced by the transient current does intercept such discontinuities.

R

RAD: — The special unit of absorbed dose. One rad is equal to an absorbed dose of 100 ergs/gram or 0.01 Joule/kilogram (0.01 gray).

RADIATION (RT): — The propagation of energy through matter or space in the form of waves. In atomic physics the term has been extended to include fast-moving particles (alpha and beta rays, free neutrons, etc.). Gamma rays and Xrays, of particular interest in atomic physics, are electromagnetic radiation in which energy is propagated in packets called photons.

RADIATION AREA: — An area, accessible to individuals, in which radiation levels could result in an individual receiving a dose equivalent in excess of 5 mrem (0.05 mSv) in any one hour at 30 centimeters from the radiation source or from any surface that the radiation penetrates.

RADIATION DETECTOR (RT): — See DETECTOR.

RADIATION ENERGY (RT): — See ENERGY, RADIATION.

RADIATION HAZARD (RT): — A situation or condition that represents potential danger to health as the result of exposure to ionizing radiation.

RADIATION METER (RT): — An instrument consisting of one or more radiation detectors, associated electronics, and an indicator of the magnitude of the measured radiation quantity.

RADIATION MONITOR (RT): — A radiation meter that is designed and used to keep track of radiation levels in a specific area, and to record those levels, or to provide an audible or visual signal when a predetermined level is exceeded.

RADIATION PROTECTION GUIDE: — The total amounts of ionizing radiation dose over certain periods of time which may safely be permitted to exposed industrial groups. These standards, established by the Federal Radiation Council, are equivalent to what was formerly called the "maximum permissible exposure."

RADIATION PROTECTION (RT): — A branch of the physical, biological, and chemical sciences applying to the prevention of the risks presented by exposure of persons to ionizing radiation.

RADIATION PROTECTION SURVEY (RT): — Evaluation of the radiation hazards in and around an area where a radiation source is used or stored. It customarily includes an examination of the arrangement and use of the source and related equipment, and measurements of exposure rates under expected operating conditions.

RADIATION QUALITY (RT): — See BEAM QUALITY.

RADIATION SAFETY OFFICER: — An individual engaged in the practices of providing radiation protection. He is the representative appointed by the licensee for liaison with the Atomic Energy Commission.

RADIATION SOURCE (RT): — A machine or a material emitting, or capable of emitting, ionizing radiation.

RADIATION SURVEY (RT): — See RADIATION PROTECTION SURVEY.

RADIOACTIVE: — Atoms that are energetically unstable and decay to a stable condition by emitting radiation are said to be radioactive.

RADIOACTIVE CONTAMINATION: — Deposition of any radioactive material in any place where it is not desired, particularly where it may be harmful.

RADIOACTIVE DECAY (RT): — The spontaneous nuclear disintegration of a material. It occurs on an atomic scale by the loss of subatomic particles (i.e., protons, neutrons, electrons, etc.). See HALF-LIFE.

RADIOACTIVE MATERIAL: — Includes any such material whether or not subject to licensing control by the Commission.

RADIOACTIVE SOURCE (RT): — A radiation source consisting of radioactive material.

RADIOACTIVITY: — Spontaneous nuclear disintegration with emission of corpuscular or electromagnetic radiation. The principal types of radioactivity are alpha disintegration, beta decay (electron emission, positron emission, and electron capture) and isomeric transition.

RADIOGRAPH (RT): — A permanent visible image on a recording medium produced by penetrating radiation passing through the material being tested.

RADIOGRAPHER: — Any individual who performs or who, in attendance at the site where the sealed source or sources are being used, personally supervises radiographic operations and who is responsible to the licensee for assuring compliance with the requirements of these regulations and the conditions of the licenses.

RADIOGRAPHER'S ASSISTANT: — Any individual who under the personal supervision of a radiographer, uses radiographer exposure devices, sealed sources or related handling tools, or survey instruments in radiography.

RADIOGRAPHER'S EXPOSURE DEVICE: — Any instrument containing a sealed source fastened or contained therein, in which the sealed source or shielding thereof may be moved, or otherwise changed, from a shielded to unshielded position for purposes of making a radiographic exposure.

RADIOGRAPHIC EXPOSURE DEVICE (RT): — See EXPOSURE DEVICE.

RADIOGRAPHIC FILM (RT): — See FILM, RADIOGRAPHIC.

RADIOGRAPHIC QUALITY LEVEL (RT): — An expression of the quality (sensitivity) of a radiograph in terms of an image quality indicator (penetrameter). When a standard hole-type penetrameter is used, quality level is stated as a-bT, where a is the penetrameter thickness, expressed as a percentage of the maximum thickness of the specimen, and b is the diameter of the smallest discernible hole, expressed as a multiple of penetrameter thickness, T. For example, the 3- 2T quality level means that the penetrameter thickness equals 3 percent of maximum specimen thickness, and the smallest discernible penetrameter hole has a diameter equal to twice the penetrameter thickness.

RADIOGRAPHIC RANGE (RT): — See LATITUDE.

RADIOGRAPHIC SCREEN (RT): — See INTENSIFYING SCREEN.

RADIOGRAPHIC SCREENS: — Metallic or fluorescent sheets used to intensify the radiation effect on films.

RADIOGRAPHIC SENSITIVITY (RT): — See SENSITIVITY, RADIOGRAPHIC.

RADIOGRAPHICALLY SIMILAR MATERIAL (RT): — A material or alloy that has approximately the same radiation

absorption as the material being radiographed.

RADIOGRAPHIC DEFINITION (RT): — See DEFINITION, RADIOGRAPHIC.

RADIOGRAPHIC INSPECTION (RT): — The use of X-rays or nuclear radiation or both to detect discontinuities in material, and to present their images on a recording medium.

RADIOGRAPHIC INTERPRETATION (RT): — The identification of subsurface discontinuities indicated on the radiograph. The evaluation as to the acceptability or rejectability of the material is based upon the judicious application of the radiographic specifications and standards governing the material.

RADIOGRAPHIC TECHNIQUE (RT): — The selection of those radiographic factors such as kilovoltage, milliamperage, type of film and screen, distance, and exposure time as to render the best possible radiographic sensitivity.

RADIOGRAPHY (RT): — A nondestructive testing method wherein a source of X-rays or gamma rays, is utilized to indicate the subsurface condition of opaque materials. A permanent record of the soundness characteristics is generally made on a specially prepared film called the radiograph.

RADIOISOTOPE: — An unstable isotope of an element that decays or disintegrates spontaneously, emitting radiation. More than 1300 natural and artificial radioisotopes have been identified.

RADIOLOGY: — That branch of medicine that uses ionizing radiation for diagnosis and therapy.

RADIUM: — A radioactive element with the atomic number 88 and an atomic weight of 226. In nature, radium is found associated with uranium, which decays to radium, by a series of alpha and beta emissions. Radium is used as a radiation source.

RANGE (UT): — The maximum ultrasonic path length that can be displayed; see SWEEP.

RATE METER (RT): — A device designed to measure radiation per unit time, as in milliroentgens per hour. It is used for detecting radiation fields and measuring the exposure rate.

RAY: — A beam of energy of small cross section.

RAYLEIGH WAVE (UT): — See SURFACE WAVE.

RBE DOSE: — RBE stands for relative biological effectiveness. An RBE dose is the dose measured in rems. (This is discussed in the report of the International Commission on Radiological Units and Measurements, 1956, NBS Handbook 62, p. 7).

REAL-TIME RADIOGRAPHY (RT): — A type of radiography in which an image is not produced photographically, but is instead produced on a fluorescent screen viewed by a video camera. The image may be intensified or enhanced before display on a television monitor. This enables radiographic interpretation concurrent with irradiation of a specimen, and lends itself to remote rapid inspection of items on an assembly line. A video recorder may be used to record the image.

RECEIVER (UT): — Search unit or transducer element, used to receive ultrasonic energy from a test part.

RECESS: — A groove or depression in a surface.

RECIPROCITY LAW (RT): — Law that states that the film blackening is determined by the product of the milliamperage or source strength and the time of exposure. See **RECIPROCITY LAW FAILURE**.

RECIPROCITY LAW FAILURE (RT): — A term used to describe situations in which the reciprocity law is not applicable. For very short or very long exposures, problems with film response time can cause the reciprocity law to fail.

RECORDING MEDIUM (RT): — A photographic film or other material that converts radiation energy into a permanent visible image.

RECRYSTALLIZATION: — (1) The change from one crystal structure to another, as occurs on heating or cooling through a critical temperature. (2) The formation of a new, strain-free grain structure from that existing in cold worked metal, usually accomplished by heating.

RECTIFICATION: — Any method by which a unidirectional voltage can be obtained from an alternating supply.

RECTIFIED ALTERNATING CURRENT: — By means of a device called a rectifier, which permits current to flow in one direction only, alternating current can be converted to direct or unidirectional current. This differs from direct current in that the current value varies from a steady level. This variation may be extreme, as in the case of half-wave rectified single-phase AC or slight, as in the case of three-phase rectified AC.

RECTIFIER: — A tube or circuit capable of converting the high voltage alternating waveform into a usable unidirectional voltage waveform.

REDUCTION: — (1) In cupping and deep drawing, a measure of the percentage decrease from blank diameter to cup diameter or of diameter reduction in redraws. (2) In forging, rolling and drawing, either the ratio of the original to final cross-sectional area or the percentage decrease in cross-sectional area.

REFERENCE BLOCKS (UT): — A block or series of blocks of material containing artificial or actual discontinuities of one or more reflecting areas at one or more distances from the test surface, which are used for reference in defining the size and distance of defective areas in materials.

REFERENCE SPECIMEN — A manufactured article, a piece of material or an actual part having one or more discontinuities that provide responses similar to the defect requiring detection. The reference specimen serves as a comparative reference to aid recognition of representative discontinuity responses. Actual defects should not be used to set an accept/reject amplitude threshold, since the defect is not reproducible. Examples would include a metal part with a true fatigue crack, and composite laminate with a natural or induced delamination or disbond.

REFERENCE STANDARD: — A material, part or specimen with known features, defects and/or material properties used to standardize, or for comparison of, equipment or instruments.

REFLECTION (UT): — An indication that has arisen as a result of an incident sound beam being reflected at the boundary of two materials of dissimilar acoustic impedance.

REFLECTOR (UT): — An interface at which an ultrasonic beam reflects.

REFRACTED BEAM (UT): — The beam that occurs in the second medium when an ultrasonic beam passes obliquely from one medium to another when each medium has different sound velocities.

REFRACTION (UT): — Change in direction of an ultrasonic beam as it passes obliquely through the interface between two materials with different acoustic velocity; see **SNELL'S LAW**.

REFRACTIVE INDEX (UT): — The ratio of the velocity of a wave in one medium to the velocity of the wave in a second medium is the refractive index of the second medium with respect to the first. It is a measure of the amount a wave will be refracted when it enters the second medium after leaving the first.

REJECT (SUPPRESSION) (UT): — A control used for minimizing or eliminating low amplitude signals (electrical or material "noise") so that larger signals are emphasized. Use of this control can reduce the vertical linearity of the amplifier.

REJECTION LEVEL (UT): — The setting of the signal level above or below which all parts are rejectable as, in an automatic system, at which objectionable parts will actuate the reject mechanism of the system.

RELATIVE EXPOSURE: — Exposure expressed relative to a standard exposure that is arbitrarily assigned the value of 1.0.

RELATIVE SPEED (RT): — The exposure time of any radiographic film relative to one particular type of film.

RELUCTANCE: — The degree of difficulty with which the magnetic flux is produced within a material. Material of high permeability has low reluctance.

REM: — The special unit of any of the quantities expressed as dose equivalent. The dose equivalent in rems is equal to absorbed dose in rads multiplied by the quality factor (1 rem = 0.01 sievert).

REMOVER (PT): — See PENETRANT REMOVER.

REPETITION RATE (UT): — The rate at which the individual pulses of acoustic energy are generated; also PULSE RATE.

REPLENISHER (RT): — A modified form of the original developer which, when added to partially exhausted developer, restores its efficiency.

RESIDUAL FIELD (MT): — See FIELD, RESIDUAL.

RESIDUAL MAGNETISM (MT): — The magnetic field remaining in a part after the current has been removed.

RESIDUAL METHOD (MT): — Bath is applied after current has been shut off; that is, the indicating particles are on the part when residual (remaining) magnetic field is present.

RESIDUAL STRESS: — Stress present in a body that is free of external forces or thermal gradients.

RESISTANCE: — Resistance is the opposition to the flow of an electrical current through a conductor. Its unit is the ohm.

RESOLUTION: — The ability of a test system to separate the signals from two indications that are close together.

RESOLVING POWER (UT): — The measure of the capability of an ultrasonic system to separate in time two discontinuities at slightly different distances or to separate the multiple reflections from the back surface of flat plates.

RESONANCE (UT): — The condition in which the frequency of the forced vibration (ultrasonic wave) is the same as the natural frequency of the body (test piece) which results in abnormally large amplitudes of vibration.

RESONANCE METHOD: — A technique in which continuous ultrasonic waves are varied in frequency to identify resonant

characteristics in order to discriminate some property of a part as thickness, stiffness, or bond integrity.

RESONANT FREQUENCY: — The frequency at which a body will vibrate freely after being set in motion by some outside force.

RESTRAINER (RT): — The constituent (e.g., potassium bromide) that reduces the activity of the developing agent but enhances its preferential action by reducing the rate of development of unexposed grains to a greater extent than it does that of exposed grains. It thus tends to reduce chemical fog.

RESTRICTED AREA: — Any area access to which is controlled by the licensee.

RESULTANT (VECTOR FIELD) (MT): — When two or more magnetizing forces operating in different directions are simultaneously applied to a ferromagnetic material, a resultant field is produced, having a direction which is determined by the relative strengths and directions of the applied magnetizing forces. Such a field is also referred to as a vector field. If either or both of the applied magnetizing forces are themselves varying in direction or amount, the resultant field is moving or swinging in direction and strength. Such a moving resultant field is sometimes referred to as a "swinging field."

RETENTIVITY (MT): — The ability of a material to retain magnetism after the current has been removed.

RETICULATION (RT): — The unequal swelling of film emulsion because of sudden change of temperature, in excess of 15°F during processing.

REVERSAL (RT): — The production of a positive instead of a negative image in an emulsion or vice versa.

RF DISPLAY (UT): — A CRT signal display that is not rectified. Displayed signals are both above and below the sweep or base line.

RINGING METHOD (UT): — A bonded structure inspection method in which unbonds are indicated by increased amplitude ringing signals.

RINGING SIGNALS (UT): — Closely spaced multiple signals can be caused by multiple reflections in a thin material or continued vibration of a transducer element.

RINGING (UT): — The time that the mechanical vibrations of a transducer element continue after the electrical pulse has stopped.

RIPPLE (RT): — The periodic variation in the potential differences between the cathode and anode of an X-ray tube, resulting from rectification of an alternating current. As the ripple is decreased by the use of filtering circuits, a constant potential is more nearly approached.

RINSE (PT): — In penetrant inspection, the operation by which the excess surface penetrant is removed from the part. Sometimes also referred to as the WASH.

RISER: — A reservoir of molten metal connected to the casting to provide additional metal to the casting, required as the result of shrinkage before and during solidification.

ROD-ANODE TUBE (RT): — A special type of X-ray tube in which the target is situated at the outer end of a long tubular anode. It usually produces panoramic radiation.

ROENTGEN (RT): — The international unit of the quantity of X or gamma radiation which cause the emission of ions carrying 1 electrostatic unit quantity of charge per 0.001293 grams of air. Designated by the letter “R”. It is usually employed to express the radiation output of a given source in terms of roentgens per hour at one meter (Rhm). Under the International System of Units this will be expressed in coulombs/kilogram ($1 r = 2.579560 \times 10^{-4} C / kg$).

ROENTGENS PER HOUR AT ONE METER (RT): — A specification of the output of a source of X- or gamma radiation in terms of the exposure rate, in roentgens per hour, measured in air at a distance of one meter from the source. Abbreviation: Rhm.

ROLL BENDING: — Curving sheets, bars and sections by means of rolls.

ROLL FLATTENING: — Flattening of sheets, that have been rolled in packs, by passing them separately through a two-high cold mill, there being virtually no deformation. Not to be confused with roller leveling.

ROLLING: — Reducing the cross-sectional area of metal stock, or otherwise shaping metal products, through the use of rotating rolls.

ROUGHNESS: — Relatively finely spaced surface irregularities, the height, width and direction of which establish the predominant surface pattern.

RT: — Symbol for the radiographic method of nondestructive testing/inspection.

RUST: — A corrosion product consisting of hydrated oxides of iron. Applied only to ferrous alloys.

S

SAFELIGHT (RT): — A special lamp used in the darkroom to provide working visibility without affecting the photosensitive emulsion of the radiographic film.

SAFETY INTERLOCK (RT): — A device for precluding access to an area of radiation hazard either by preventing entry or by automatically removing the hazard.

SAND: — A granular material resulting from the disintegration of rock. Foundry sands are mainly silica. “Bank sands” are found in sedimentary deposits and contain less than 5% clay. “Dune” sand occurs in wind blown deposits near large bodies of water and is very high in silica content. “Moulding sand” contains more than 5% clay; usually between 10 and 20%. “Silica sand” is a granular material containing at least 95% silica and often more than 99%. “Sand core” is nearly pure silica. “Miscellaneous sand” includes zircon, olivine, calcium carbonate, lava, and titanium minerals.

SAND BLAST: — (Grit Blast) The use of sand or grit at high velocity through air pressure to clean surfaces.

SAPONIFY (PT): — Converting chemicals into soap; involves the alkaline hydrolysis of a fat or oil, or the neutralization of a fatty acid.

SATURATION (MT): — The point in the magnetization of a magnetizable object at which an increase in the magnetizing force produced no increase in the magnetic field within the part.

SATURATION (UT): — A term used to describe full vertical screen amplitude (100%). Beyond this point there is no visual display to estimate the actual real height of the response signal unless the equipment is provided with dB readout.

SCAB: — A defect consisting of a flat volume of metal joined to a casting through a small area. It is usually set in a depression, a flat side being separated from the metal of the casting proper by a thin layer of sand.

SCALE: — Oxide formed on metal by chemical action of the surface metal with oxygen from the air.

SCALING: — (1) Forming a thick layer of oxidation products on metals at high temperatures. (2) Depositing water-insoluble constituents on a metal surface, as in cooling tubes and water boilers.

SCANNING (ET, UT): — Relative movement of the search unit over a test part.

SCARFING: — Cutting surface areas of metal objects, ordinarily by using a gas torch. The operation permits surface defects to be cut from ingots, billets or the edges of plate that is to be beveled for butt welding.

SCATTER (RT): — One of the causes of haziness or fog. Some of the incident radiation is scattered by atomic electrons of the object being radiographed much as light is dispersed by fog. Any material, whether specimen, cassette, tabletop walls, floors, etc., receiving direct radiation, is a source of scattered radiation.

SCATTER UNSHARPNESS (RT): — See UNSHARPNESS.

SCATTERED ENERGY (UT): — Energy that is reflected in a random fashion by small discontinuities in the path of a sound beam.

SCATTERED RADIATION (RT): — Radiation that, as the result of interaction with matter, has had its direction changed and, for some interactions, its energy decreased.

SCATTERING (RT): — A change of direction, and possibly reduction of energy, of an incident particle or photon as the result of interaction with an atom, nucleus, or other particle.

SCINTILLATION (RT): — A localized flash of light caused by a particle or photon of ionizing radiation incident on a fluorescent material.

SCINTILLATION COUNTER: — A device for counting atomic particles by means of tiny flashes of light (scintillations) which the particles produce when they strike certain crystals.

SCINTILLATOR (RT): — A substance that emits a localized flash of light when excited by an incident particle or photon of ionizing radiation.

SCORING: — (1) Marring or scratching of any formed part by metal pickup on the punch or die. (2) Reducing the thickness of a material along a line to weaken it purposely along that line.

SCRATCH: — A shallow mark or injury produced by abrasion.

SCREEN (RT): — Alternative term for intensifying screen.

SCREENS, FLUORESCENT (RT): — See FLUORESCENT SCREENS.

SCREENS, INTENSIFYING (RT): — See INTENSIFYING SCREENS.

SCREENS, LEAD (RT): — Layers of lead foil, used in intimate contact with the film during exposure. They act to improve radiographic quality or to decrease exposure time, or both.

SCREEN-TYPE FILM (RT): — A radiographic film produced specially to be used with fluorescent screens. This type of film has high sensitivity to the fluorescent light emitted by such screens under the effect of ionizing radiation. (Improperly called screen film.)

SEALED SOURCE: — Any by-product material that is encased in a capsule designed to prevent leakage or escape of the by-product material.

SEAM: — A discontinuity caused by a void or crack in rolled material parallel to the axis of the material which although closed is not welded. A line of junction; a line, groove, ridge, or interstice formed by or between two contracting edges.

SEARCH UNIT (UT): — A device for generating and/or receiving ultrasonic energy; may contain one or more transducer elements or, in the case of the Harmonic Bond Tester, a microphone and coil.

SECONDARY MAGNETIC FIELD (ET): — In eddy current testing, the magnetic field produced by the eddy currents in the test material. The secondary field opposes the primary field.

SECONDARY RADIATION (RT): — Radiation other than primary radiation emerging from irradiated matter.

SEGREGATION: — Where a metallic constituent which cools last, forms a final brittle film between crystals. It may also be a concentration of non-metallic impurities. Segregations may occur at the center or be grouped in some regular form about the center.

SELF-EMULSIFIABLE (PT): — (Water-Washable) Self-emulsifiable material is an oil base material containing an emulsifying agent that forms an emulsion when rinsed with water.

SELF-RECTIFYING TUBE (RT): — Any hot-cathode X-ray tube that permits current to flow only from the cathode to the anode, when the anode is kept cool.

SENSITIVITY: — A general term for the smallest detectable detail or indication for a given system and conditions.

SENSITIVITY, IQI (RT): — See IQI SENSITIVITY.

SENSITIVITY, RADIOGRAPHIC: — The ratio of the smallest difference in thickness that is detectable on the radiograph to the thickness of the specimen. It may be expressed as a percentage, and is an indication of ability to detect a small discontinuity. In practice, it is determined by the use of an image quality indicator (penetrameter).

SENSITIVITY, SPECTRAL (RT): — The variation in radiographic exposure, as a function of X-ray energy, required to produce a given film density.

SETTLING TEST (MT): — See CONCENTRATION TEST.

SHALLOW DISCONTINUITY: — A discontinuity open to the surface of a solid object which possesses little depth in proportion to the width of this opening. A scratch or nick may be a “shallow discontinuity” in this sense.

SHALLOW-DOSE EQUIVALENT: — As it applies to external exposure of the skin or an extremity, is taken as the dose equivalent at a tissue depth of 0.007 centimeters (7 mg/cm²) averaged over an area of 1 square centimeter.

SHARPNESS (RT): — See DEFINITION, RADIOGRAPHIC (RT).

SHEAR: — That type of force which causes or tends to cause two contiguous parts of the same body to slide relative to each other in a direction parallel to their plane of contact.

SHEAR WAVE (UT): — A type of wave in which the particle motion is perpendicular to the direction of propagation.

SHEET: — A flat-rolled metal product of some maximum thickness and minimum width arbitrarily dependent on the type of metal. It is thinner than plate.

SHIELD: — A layer or mass of material used to reduce the passage of ionizing radiation.

SHOE (UT): — Device used to adapt a straight beam search unit for use in a specific type of inspection such as inspection of a curved surface, angle beam or surface wave inspection, inspection around a fastener hole, etc. Also, see WEDGE.

SHOT PEENING: — Cold working the surface of a metal by metal-shot impingement.

SHRINKAGE CAVITIES: — Cavities in castings caused by lack of sufficient molten metal as the casting cools.

SHRINKAGE CAVITY (ON RADIOGRAPH): — A small bubble in metal that appears as a dendritic, filamentary, or jagged darkened area on a radiograph film.

SHRINKAGE CRACKS: — Hot tears associated with shrinkage cavities.

SHRINKAGE POROSITY OR SPONGE: — (NONFERROUS ALLOYS).

SHRINKAGE POROSITY OR SPONGE (NONFERROUS ALLOYS, RADIOGRAPHIC): — A localized lacy, or honeycombed, darkened area on a film that indicates porous metal.

SHUTTER (RT): — A device that incorporates a movable shield used to block the useful beam emitted from a source housing.

SIDE LOBE ENERGY (UT): — Ultrasonic energy emitted from a search unit to the sides of the main sound beam.

SIEVERT (Sv): — SIEVERT (Sv): The SI unit of any of the quantities expressed as dose equivalent. The dose equivalent in sieverts is equal to the absorbed dose in grays multiplied by the quality factor (1 Sv = 100 rems).

SIGNAL: — Displayed response from an electrical impulse or wave.

SIGNAL-TO-NOISE RATIO: — The ratio of the signal from the variable of interest to signals from variables which are of no interest.

SILVER HALIDE (RT): — A compound of silver with one of the halogen elements, e.g., silver bromide.

SINGLE-PHASE ALTERNATING CURRENT: — This term refers to a simple current, alternating in direction. Commercial single-phase current follows a sine wave. Such a current requires only two conductors for its circuit. Most common commercial frequencies are 25, 50 and 60 cycles per second.

SKIN EFFECT (MT, EC): — The phenomenon that causes current to flow along the surface of a conductor. As frequency increase, skin depth decreases.

SKIP DISTANCE (UT): — In angle beam testing, the distance from the sound entry point to the first reflection point on the same test surface; also sometimes called V-Path.

SKY SHINE (RT): — Scatter radiation caused by interaction of the X-ray photons with the atoms in the air molecules, or structures in the vicinity, and radiates back toward the earth. Skyshine can be detected at considerable distance from the source, therefore, it should be considered when establishing barriers, etc.

SLAG: — A non-metallic residue that forms on molten metal as a result of the combining of impurities.

SLAG INCLUSIONS: — Nonmetallic solid material entrapped in weld metal or between weld metal and base metal.

SLOUGHING (RT): — The loosening of an emulsion from its base, commencing at the edges. It is usually caused by prolonged immersion in a liquid at too high a temperature or of unsuitable chemical composition.

S-N DIAGRAM: — A plot showing the relationship of stress, S, and the number of cycles, N, before failure in fatigue testing.

SOD (RT): — Source to object distance. The distance between X-ray tube or radioisotope and the object being radiographed.

SOFT X-RAYS: — A term used to express the quality or penetrating power of X radiation; their penetrating power is relatively light.

SOLENOID: — A solenoid is a coil consisting of a number of loops of wire or cable to carry electric current. It may be used for both magnetizing and demagnetizing purposes.

SOLUBLE (PT): — The amount of a substance that will dissolve in a given amount of another substance and is typically expressed as the number of parts by weight dissolved by 100 parts of solvent at a specified temperature and pressure or as a percent by weight or by volume.

SOLUTION HEAT TREATMENT: — A heat treatment in which an alloy is heated to a sufficiently high temperature to permit many or all of the alloying elements to become randomly dispersed throughout the metal.

SOLVENTS: — A liquid containing no emulsifiers and having chemical properties similar to those exhibited by solvents conforming to Government Specifications TT-N-97 and A-A-2904.

SOLVENT ACTION: — The dissolution of a fluid or solid by another material.

SOLVENT CLEANING (PT): — The process of removing the excess penetrant from the surface of a part by washing or wiping with a solvent for the penetrant.

SOLVENT DEVELOPER (PT): — A developer in which the developing powder is applied as a suspension in a quick drying solvent.

SOURCE (RT): — The origin of radiation; an X-ray tube or radioisotope.

SOURCE-FILM DISTANCE (SFD) (RT): — The distance between the focal spot of an X-ray tube or radiation source and the film generally expressed in inches.

SOURCE MATERIAL: — In atomic energy law, any material, except special nuclear material, which contains 0.05% or more of uranium, thorium, or any combination of the two.

SOURCE MATERIAL (RT): — Any material, except special nuclear material, which contains 0.05 percent or more of uranium, thorium, or any combination of the two.

SOURCE SIZE, EFFECTIVE: — The apparent dimensions, as viewed along the beam axis, of that portion of the source from which ionizing radiation are emitted. For the purpose of calculating geometric unsharpness, the effective dimensions must always be used.

SPECIFIC ACOUSTIC IMPEDENCE (UT): — A factor that determines the amount of reflection that occurs at an interface and represents the product of the density of the medium in which the wave is propagating and the wave velocity.

SPECTRAL SENSITIVITY (RT): — The areas of the EMR spectrum to which a film is sensitive. Silver bromide films are all sensitive to ultraviolet and blue light as well as X-rays. Screen-type medical X-ray films are designed to be particularly sensitive to blue light and ultraviolet radiation from fluorescent screens, but some X-ray films are designed to be used without screens and are particularly sensitive to direct exposure from X-rays.

SPECTRUM: — An orderly array of the components of a beam of electromagnetic waves according to their frequency, wavelength, or energies.

SPEED, FILM (RT): — See FILM SPEED.

STABLE ISOTOPE: — A nuclide that does not undergo radioactive decay.

STANDARD: — (1) A reference used as a basis for comparison or calibration. (2) A concept that has been established by authority, custom, or agreement to serve as a model or rule in the measurement of quantity or the establishment of a practice or procedure.

STANDARD DEPTH OF PENETRATION (ET): — The depth at which the eddy current field has fallen to $1/e$, or 37 percent, of its strength at the surface. In practice, it is generally used to define the sensing limit of the eddy current field.

STANDARDIZATION — The process of adjusting an instrument for a comparative test where an indication from a part under inspection is compared to a reference indication. Standardization prepares the instrument for a comparative test.

STANDING WAVES (UT): — Waves that exist in a body when the thickness of the body is equal to an integral number of $1/2$ wave lengths (thickness equal to $1/2$, 1, $1 1/2$, 2, or $2 1/2$, etc., wave lengths); used with the resonance method.

STEPPED WEDGE (RT): — A device that is used, with appropriate penetrameters on each step, for the inspection of parts having great variations in thickness or a complex geometry. The stepped wedge must be made of material radiographically similar to that being radiographed.

STEREORADIOGRAPHY (RT): — The process of finding the position and dimensions of details within a specimen by measurements made on radiographs taken from different directions.

STEREOSCOPIC (RT): — A type of viewing that employs an optical instrument (stereoscope) to combine the images of

two radiographs taken from slightly different angles, thus achieving a three-dimensional effect.

STEREOSCOPY (RT): — The three-dimensional visual effect resulting from binocular vision.

STIFFNESS: — The ability of a metal or shape to resist elastic deflection. For identical shapes, the stiffness is proportional to the modulus of elasticity.

STOP BATH (RT): — A chemical solution (or clean running water) used for arresting the activity of the developer remaining in the film emulsion.

STRAIGHT BEAM (UT): — A vibrating pulse wave train traveling normal to the test surface.

STRAIN: — The change per unit of length in a linear dimension of a stressed body. It may be thought of as the deformation caused by an applied load and is measured in inches of change per inch of stressed length, or in percentage of dimensional change of a specified stressed length.

STRAY RADIATION (RT): — Radiation other than the useful beam. It includes leakage, secondary, and scattered radiation.

STRESS: — Force per unit area, often thought of as force acting through a small area within a plane.

STRESS-CORROSION CRACKING: — Failure by cracking under combined action of corrosion and stress, either external (applied) or internal (residual). Cracking may be either intergranular or transgranular, depending on metal and corrosive medium.

STRINGER: — In wrought materials, an elongated configuration of microconstituents or foreign material aligned in the direction of working. Commonly, the term is associated with elongated oxide or sulfide inclusions in steel.

SUBSTRATE: — Layer of metal underlying a coating, regardless of whether the layer is basis metal.

SUBSURFACE CORROSION: — Formation of isolated particles of corrosion products beneath the metal surface. This results from the preferential reaction of certain alloy constituents by inward diffusion of oxygen, nitrogen and sulfur.

SUB-SURFACE DEFECT: — Any defect which does not break the surface of the part in which it exists.

SUBSURFACE INDICATION: — Any indication that does not open onto the surface of the part in which it exists.

SUPPRESSION (UT): — See REJECT.

SURFACE FINISH: — (1) Condition of a surface as a result of a final treatment. (2) Measured surface profile characteristics, the preferred term being ROUGHNESS.

SURFACE INDICATION: — Any indication that is open onto the surface of the part in which it exists.

SURFACE IRREGULARITY (RT): — An image on a radiograph that corresponds to an irregularity visible on the surface of a specimen.

SURFACE TENSION (PT): — That property due to molecular forces, by which the surface of all liquids tends to bring the

contained volume into a form having the least superficial area.

SURFACE WAVE (UT): — A type of wave which travels along a surface; characterized by elliptical particle motion having effective penetration less than one wave length.

SURFACTANT (PT): — (Surface active agent) A soluble compound that reduces the surface tension of liquids, or reduces interfacial tension between two liquids or a liquid and a solid.

SURVEY: — An evaluation of the radiological conditions and potential hazards incident to the presence of radiation. When appropriate, such an evaluation includes a physical survey of the location and measurements or calculations of the levels of radiation.

SURVEY METER (RT): — A portable instrument that measures dose rate of exposure or radiation intensity.

SUSPENSION (MT): — The correct term applied to the liquid bath in which is suspended the ferromagnetic particles used in the wet magnetic particle inspection method.

SWEEP (UT): — The uniform and repeated movement of an electron beam across the CRT.

SWEEP DELAY (UT): — See DELAYED SWEEP. A delay in time, after the initial pulse, of starting the sweep presentation; also used to denote the control used for adjusting the time of starting the sweep presentation.

SWEEP LENGTH (UT): — Length of time or distance represented by the horizontal base line on an A-scan.

SYSTEM CONCEPT (PT): — A combination of penetrant and emulsifier supplied by one manufacturer and intended to perform a specific type or process of inspection. The term "Family Concept" has been changed to "System Concept" to comply with DOD standardization requirements.

T

TAPE TRANSFER (MT): — The use of colorless tape to lift a magnetic particle indication from a part.

TARGET (RT): — The area on the anode of an X-ray tube on which the electron stream impinges and from which the primary beam of X-rays is emitted.

TEAR, HOT: — Same as CRACK, HOT; but developing before the casting has completely solidified.

TEAR, MACHINING: — See CRACKS, MACHINING.

TECHNIQUE CHART (RT): — See EXPOSURE CHART.

TEMPLATE: — A guide, gage or pattern for checking dimensions or locations.

TENSILE STRENGTH: — The maximum stress that a material is capable of withstanding without breaking under a gradually and uniformly applied load. Other terms commonly used to express the same thing are ultimate tensile strength and, less accurately, breaking strength.

TENTH-VALUE LAYER (TVL) (RT): — The thickness of the layer of a specified substance which, when introduced into

the path of a given narrow beam of radiation, reduces the intensity of this radiation to one-tenth the original value.

TESLA: — Magnetic flux density, abbreviated T, also weber per meter squared. See also GAUSS.

TEST BLOCK: — See REFERENCE STANDARD.

TEST FREQUENCY: — The number of complete input cycles per unit time of a periodic quantity such as alternating current employed for a specified inspection. The test frequency is always considered to be the fundamental whenever harmonics are generated in the process of testing certain materials such as ferromagnetic materials.

TEST PART: — A part, material, or assembly being inspected.

TEST SURFACE: — Surface of an item subject to inspection or entry surface of the inspection method energy.

THERMAL ANALYSIS: — A method for determining transformations in a metal by noting the temperatures at which thermal arrests occur. These arrests are manifested by changes in slope of the plotted or mechanically traced heating and cooling curves. When such data are secured under nearly equilibrium conditions of heating and cooling, the method is commonly used for determining certain critical temperatures required for the construction of equilibrium diagrams.

THERMAL STRESSES: — Stresses in metal, resulting from non-uniform temperature distribution.

THERMIONIC EMISSION (RT): — The emission of electrons from the surface of a heated material by virtue of their thermal energy.

THERMOLUMINESCENCE (RT): — The property possessed by certain crystals, of emitting light when heated after having been exposed to ionizing radiation.

THERMOLUMINESCENCE DOSIMETER (TLD) (RT): — A dosimeter, commonly used as a personnel monitor that uses thermoluminescent material. The total amount of light emitted upon heating of the material is proportional to the amount of radiation energy absorbed.

THETA (θ): — Symbol for the half angle of beam spread; the Greek letter Theta.

THORIATED TUNGSTEN FILAMENT (RT): — A vacuum-tube filament consisting of tungsten mixed with thorium oxide to give improved electron emission. Also known as thoriated emitter.

THORIUM: — A heavy malleable, radioactive metal used in the manufacture of thoriated tungsten target material in the X-ray tube head.

THREE-PHASE ALTERNATING CURRENT: — Commercial, electricity is commonly transmitted as three single phase currents, that is, three separate currents following separate sine curves, each at 60 cycles (or other frequency) per second, but with the peaks of their individual curves one-third of a cycle apart. At least three (sometimes four) conductors are required for three-phase alternating current.

THRESHOLD: — In reference to currents or magnetic fields, the minimum strength necessary to create a looked-for effect is called the threshold value. For example, the minimum current necessary to produce a readable indication at a given defect, is the threshold value of current for that purpose.

THROUGH TRANSMISSION METHOD (UT): — An inspection method in which ultrasonic energy is generated by one

search unit and received by another at the opposite surface of the test part.

THULIUM-170: — A radioisotope of the element thulium.

TIME DELAY (UT): — See SWEEP DELAY.

TLD (RT): — See THERMOLUMINESCENCE DOSIMETER.

TOLERANCE: — The specified permissible deviation from a specified nominal dimension, or the permissible variation in size of a part.

TOMOGRAPH (RT): — A radiograph of a specified plane of a deep structure.

TOMOGRAPHY (RT): — The radiography of a predetermined interior plane of a thick material. In one method the Xray tube and the film are moved simultaneously in opposite directions about a pivotal point in the plane of the layer.

TOUGHNESS: — Ability of a metal to absorb energy and deform plastically before fracturing. It is usually measured by the energy absorbed in a notch impact test, but the area under the stress- strain curve in tensile testing is also a measure of toughness.

TOXIC: — The quality of certain materials being proportionally poisonous, as indicated by jeopardy to life, health or comfort.

TRANSDUCER (UT): — An electroacoustical device for converting electrical energy into acoustical energy and vice versa.

TRANSDUCER ELEMENT (UT): — A piezoelectric element in a search unit.

TRANSFER: — Compensation for differences in signal amplitude from equivalent reflectors in a test part and the reference standard used in an inspection.

TRANSMISSION CHARACTERISTICS (UT): — Test part characteristics that influence the transmitting and receiving of ultrasonic energy in an inspection; includes surface effects and internal effects.

TRANSMITTER (UT): — Search unit or transducer element, used to generate ultrasonic energy to be transmitted into a test part.

TRANSVERSE: — Literally, "across," usually signifying a direction or plane perpendicular to the direction of working.

TRANSVERSE WAVE (UT): — See SHEAR WAVE.

TUBE CURRENT (RT): — The current flowing between the cathode and anode during the generation of radiation by an X-ray tube.

TUBE DIAPHRAGM (RT): — An adjustable device, normally attached to a tube housing, that limits the cross section of the emergent X-ray beam.

TUBE FILTER (RT): — A filter that can be attached to the X-ray tube housing.

TUBE HOUSING (RT): — An enclosure that contains an X-ray tube and has a port through which the useful beam is emitted. The tube housing may also contain transformers and other appropriate components.

TUBE RATING (RT): — The maximum electrical power (in watts) that can be safely applied to an X-ray tube for a specified period.

TUBE SHIELD (RT): — The housing of an X-ray tube that normally provides protection against electric shock and affords a degree of protection against radiation.

TUBE STAND (RT): — A support, often in the form of one or more vertical pillars with adjustable attachments, for holding an X-ray tube in position for use.

TUBE WINDOW (RT): — The relatively thin section of the X-ray tube through which the useful beam emerges. (Materials have different absorption properties, and thus some "Windows" are designated by their material, e.g., "Beryllium Window".)

TUNED: — Having a relatively narrow bandwidth; used to describe instruments having an initial pulse with a relatively narrow bandwidth and/or an amplifier with response to a relatively narrow range of frequencies.

TUNGSTEN ALLOY (HEAVY ALLOY) (RT): — A shielding material containing tungsten, copper, and nickel, and having a density about 50 percent greater than that of lead.

TUNGSTEN INCLUSIONS: — Inclusions in welds resulting from particles or splinters of tungsten welding electrodes.

TWO-FILM TECHNIQUE (RT): — A procedure wherein two films of different relative speeds are used simultaneously to radiograph both the thick and the thin sections of an item.

U

ULTRASONIC: — Pertaining to mechanical vibrations having a frequency greater than approximately 20,000 hertz.

ULTRASONIC TESTING: — A nondestructive method of testing materials by transmitting high frequency sound waves through them.xxxxxx

UMBRA (RT): — A region behind an object in a beam of radiation such that a straight line drawn from any point in this region to any point in the source passes through the object. The umbra is sometimes referred to as the region of total shadow.

UNBOND: — An area within a bonded interface between two adherends in which the intended bonding action failed to take place. Also used to denote specific areas deliberately prevented from bonding in order to simulate a defective bond, such as in the generation of reference standards.

UNDERCUT (RT): — A depression or groove adjoining the toe of a weld in a metal object. Appears on a radiograph as a dark area.

UNDERCUT (RT): — Undercut is a term that is used to describe the excessive radiation intensity that may be found at the edge of an object. Such undercutting is usually associated with scattered radiation.

UNIDIRECTIONAL: — Having one direction only.

UNIDIRECTIONAL VOLTAGE: — A voltage of which the polarity, but not necessarily the magnitude is constant.

UNRESTRICTED AREA (RT): — Any area to which access is not controlled for purposes of radiation protection.

UNSHARPNESS (RT): — Unsharpness is a term used to describe the lack of definition of an edge due to geometric factors related to the source size and the source-to-film distance.

USE FACTOR (RT): — The fraction of the workload during which the useful beam is pointed in the direction under consideration when designing shielding. Symbol: U.

USEFUL BEAM (RT): — All radiation that emerges from a source housing or an X-ray tube assembly through a port, diaphragm, or cone.

Ultraviolet A (UV-A) — The term given to electromagnetic radiation having wavelengths from 320-400 nm. Typical units used in penetrant and magnetic particle inspection provide an intensity of 100 to 150 foot-candles at 15 inches from the face of the filter and are used to excite fluorescent materials in a range visible to the eye. Often referred to as "black light."

UT: — Symbol for the ultrasonic method of nondestructive testing/inspection.

UV-A INTENSITY (PT, MT): — The amount of properly filtered UV-A measured at the surface of the part being inspected.

UV-A FILTER (PT, MT): — A filter that transmits ultraviolet light (320-400-nm wavelength) while suppressing the transmission of visible light of the longer wavelengths.

V

v: — Symbol for velocity.

VELOCITY (UT): — The distance an ultrasonic wave travels in unit time.

VERTICAL LINEARITY (UT): — Constant relationship between the amplitude of the indications on an A-scan display and the corresponding magnitudes of the reflected ultrasonic waves from reflectors of known size.

VERY HIGH RADIATION AREA: — An area, accessible to individuals, in which radiation levels could result in an individual receiving an absorbed dose in excess of 500 rads (5 grays) in 1 hour 1 meter from a radiation source or from any surface that the radiation penetrates.

— **NOTE:** At very high doses received at high dose rates, unit of absorbed dose (e.g., rads and grays) are appropriate, rather than units of dose equivalent (e.g., rems and sieverts). The maximum dose rate 1 meter from the aperture of the Lorad LPX-160A Industrial X-ray Unit is 2.4 grays (240 RDAs) per minute at 0.5 meters thus the maximum dose received in one hour would equate to about 0.6 grays (60 RDAs) per minute. As such, "Very High Radiation" areas can exist for this and comparable radiation sources.

VISCOSITY: — A measurement of a liquids resistance to change of shape or flow. That property of a body by virtue of which, when flow occurs inside it, forces arise in such a direction as to oppose the flow. Also referred to as flow resistance.

VISIBLE: — Capable of being discerned by the eye.

VISIBLE DYE PENETRANT (PT): — An intensely colored (usually red) highly penetrating liquid which will provide maximum contrast with the white developer when used for detection of surface discontinuities under normal light.

VISIBILITY (MT): — The ability of magnetic particles to be seen against a contrasting background.

VOID: — Discontinuities in which there is a physical separation between opposite walls.

VOLTAGE: — The unit of electromotive force that tends to cause an electric current to flow through a conductor.

W

WATER-BREAK (MT): — A method of testing the water suspension for the proper amount of wetting agent. The inability of the rinse water to cover the entire surface in an unbroken film.

WATER-COOLED TUBE (RT): — An X-ray tube for which the principal method of cooling is dissipation of heat, directly or indirectly, by means of water.

WATER DELAY COLUMN (UT): — A hollow column filled with water and attached to a search unit; causes a time delay between the initial pulse and front surface signal.

WATER PATH (UT): — In immersion inspection or inspection using a water column delay, the distance from the search unit face to the test part front surface.

WATER TOLERANCE (IT): — The amount of water that a penetrant or emulsifier can absorb before its effectiveness is impaired.

WATER WASHABLE (PT): — A water-washable penetrant is an oil-like material containing an emulsifying agent that makes it washable by water rinsing.

WATER-WASHABILITY (PT): — The property of a penetrant that permits it to be cleaned from the surface of a part by washing with water.

WAVE FRONT (UT): — In a wave disturbance, a continuous surface drawn through the most forward points which have the same phase.

WAVELENGTH: — The distance between two points having the same phase in two consecutive cycles of a periodic wave, along a line in the direction of propagation.

WEAR FACE (UT): — A device attached to the face of a search unit to prevent wear of the transducer element.

WEDGE (UT): — A device used to direct ultrasonic energy into a test part at an angle; also, see SHOE.

WELD BEAD: — A deposit of filler metal from a single welding pass.

WELD CRACK: — A crack in weld metal.

WELD METAL: — That portion of a weld which has been melted during welding.

WELD NUGGET: — The weld metal in spot, seam or projection welding.

WELD REINFORCEMENT: — (1) In a butt joint, weld metal on the face of the weld that extends out beyond a surface plane common to the members being welded. (2) In a fillet weld, weld metal that contributes to convexity. (3) In a flash, upset or gas pressure weld, the original diameter or thickness.

WET CONTINUOUS PROCESS (MT): — The method of applying the wet suspension to the inspection surfaces just prior to applying the magnetizing current.

WET DEVELOPER (IT): — A developer in which the developing powder is applied as a suspension or solution in a liquid, usually water.

WET METHOD (MT): — The magnetic particle inspection method employing ferromagnetic particles suspended in a liquid bath.

WETTING ACTION (MT): — The ability of a solution to adhere to the surface of an object.

WETTING AGENT (RT, MT): — In film processing, a chemical additive to the final water rinse to promote complete wetting of the film, thus assuring adequate washing away and neutralization of the prior processing solutions and prevention of water spots during the drying cycle. In magnetic particle inspection a material added to liquid that enables it to wet and cover surfaces that the liquid itself would ordinarily not wet.

WHEEL SEARCH UNIT (UT): — Ultrasonic device which couples ultrasonic energy to a test part through the rolling contact area of a wheel containing a liquid and one or more transducer elements.

WHOLE BODY: — Means, for purposes of external exposure, head, trunk (including male gonads), arms above the elbow or legs above the knee.

WIRE PENETRATOR (RT): — An image quality indicator incorporating a series of wires that are graded in diameter and usually of similar material to the specimen under examination.

WORKLOAD (RT): — The output of a radiation machine or a radioactive source integrated over a suitable time and expressed in appropriate units.

X

X-RADIATION (RT): — See X-RAYS.

X-RADIOGRAPHY (RT): — The process of producing radiographs using X-rays.

X-RAYS (RT): — A form of radiant energy resulting from the bombardment of a suitable target by electrons produced in a vacuum by the application of high voltages. X-rays have wavelengths between 10^{-11} cm and 10^{-6} cm.

X-RAY FILM (RT): — A film base that is coated (usually on both sides) with an emulsion designed for use with X-rays.

X-RAY TUBE (RT): — A vacuum tube intended for the production of X-rays by bombarding the anode with a beam of electrons accelerated under a difference of potential between anode and cathode.

Y

YIELD POINT: — The load (in psig) at which a marked increase in deformation occurs without an increase in load.

YIELD STRENGTH: — The stress at which a material exhibits a specified deviation from proportionality of stress and strain. An offset of 0.2% is used for many metals.

YOKE (MT): — A "C" shaped piece of soft magnetic material either solid or laminated, around which is wound a coil carrying the magnetizing current.

YOKE MAGNETIZATION (MT): — A longitudinal magnetic field induced in a part, or in an area of a part, by means of an external electromagnet shaped like a yoke.

Z

Z: — Symbol for acoustic impedance.

ZIRCON SAND: — A highly absorptive material used as a blocking or masking medium for drilled holes, slots and highly irregular geometric parts to reduce or eliminate scattered radiation.

